

RETE SEMICONDUCTORS

RF Wideband Transistors



1998

**Data Handbook SC14
CD-ROM included**

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DEFINITIONS

| Data sheet status | |
|---|---|
| Objective specification | This data sheet contains target or goal specifications for product development. |
| Preliminary specification | This data sheet contains preliminary data; supplementary data may be published later. |
| Product specification | This data sheet contains final product specifications. |
| Limiting values | |
| Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability. | |
| Application information | |
| Where application information is given, it is advisory and does not form part of the specification. | |

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These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips for any damages resulting from such improper use or sale.

PREFACE

Dear Customer,

We are pleased to introduce the new data handbook SC14: RF Wideband Transistors.

It contains data on our extensive range of Wideband Transistors, covering five generations of these devices.

Over the years we have built up an enviable reputation with these products, providing cost-effective solutions in low noise amplifiers especially for cellular and cordless telephony applications.

Our **NEW** 5th generation devices:

BFG403W, BFG410W, BFG425W and BFG21W are manufactured in our new double-polysilicon technology, which dramatically improves the performance of low-voltage, silicon-based RF transistors.

To assist you with actual design work, a CD ROM is included containing application notes and SPICE models. Even a copy of the product specifications of all types in this SC14 handbook is available on the CD ROM.

For further information, please visit our [WWW](http://www.philips.com) site or contact your local Philips Semiconductors sales office or our franchised distributors.

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Selection guide

FIRST GENERATION NPN WIDEBAND TRANSISTORS (f_T up to 3.5 GHz)

| f_T / I_C CURVE (see Fig.1) | PACKAGE | | | | | |
|----------------------------------|-----------------|----------------|-------|--------|--------|--------|
| | LEADED | SURFACE-MOUNT | | | | |
| | SOT54 | SOT23 | SOT89 | SOT143 | SOT223 | SOT323 |
| (1) | | BFT25 | | | | |
| (2) | | BF747 BF547 | | | | BF547W |
| (3) | BF689K BF763 | BFS17 | | | | BFS17W |
| (4) | | BFS17A | | BFG17A | | |
| (5) | | BFR53 | | | | |
| (6) | | | BFQ17 | | BFG16A | |

SECOND GENERATION WIDEBAND TRANSISTORS (f_T up to 6 GHz)

| f_T / I_C CURVE (see Fig.1) | POLARITY | PACKAGE | | | | | |
|----------------------------------|----------|---------|---------------|--------|---------------------|--------|---------|
| | | CERAMIC | SURFACE-MOUNT | | | | |
| | | SOT122 | SOT23 | SOT89 | SOT143 (note 1) | SOT223 | SOT323 |
| (7) | NPN | | BFR92(A) | | BFG92A (/X)(/XR) | | BFR92AW |
| | PNP | | BFT92 | | | | BFT92W |
| (8) | NPN | | BFR93(A) | | BFG93A (/X)(/XR) | BFG94 | BFR93AW |
| (9) | PNP | | BFT93 | | | | BFT93W |
| (10) | NPN | | BFR106 | BFQ19 | | BFG97 | |
| | PNP | | | BFQ149 | | BFG31 | |
| (11) | NPN | BFQ34 | | BFQ18A | | BFG35 | |
| (12) | NPN | BFQ68 | | | | | |
| (13) | NPN | BFQ136 | | | | | |

Note

- SOT143 package is available with alternative pinning.
European pinning - no type number suffix; USA pinning - suffix /X; Japanese pinning - suffix /XR.
Brackets around the suffixes (/X) and (/XR) denote pinning options. No brackets means no options,
(e.g. BFG25A/X: only available with USA pinning).

THIRD GENERATION NPN WIDEBAND TRANSISTORS (f_T up to 8 GHz)

| f_T / I_C CURVE (see Fig.1) | PACKAGE | | | | |
|----------------------------------|---------|---------------|---------------------|--------|--------|
| | CERAMIC | SURFACE-MOUNT | | | |
| | SOT172 | SOT23 | SOT143 (note 1) | SOT223 | SOT323 |
| (14) | | BFQ67 | BFG67 (/X)(/XR) | | BFQ67W |
| (15) | | | BFG197 (/X)(/XR) | BFG198 | |
| (16) | BFQ135 | | | BFG135 | |
| (17) | BFQ270 | | | | |

Note

- SOT143 package is available with alternative pinning.
European pinning - no type number suffix; USA pinning - suffix /X; Japanese pinning - suffix /XR.
Brackets around the suffixes (/X) and (/XR) denote pinning options. No brackets means no options,
(e.g. BFG25A/X: only available with USA pinning).

FOURTH GENERATION NPN WIDEBAND TRANSISTORS (f_T up to 10 GHz)

| f_T / I_C CURVE (see Fig.1) | PACKAGE | | | | | | | |
|----------------------------------|---------|---------------|---------------------|--------|--------|----------------------|------------------|--------|
| | CERAMIC | SURFACE-MOUNT | | | | | | |
| | SOT172 | SOT23 | SOT143 (note 1) | SOT223 | SOT323 | SOT343 (note 1) | SOT353 | SOT363 |
| (18) | | BFT25A | BFG25A/X | | BFS25A | BFG25AW (/X)(/XR) | | |
| (19) | | BFR505 | BFG505 (/X)(/XR) | | BFS505 | BFG505W (/X)(/XR) | BFC505 BFE505 | BFM505 |
| (20) | | BFR520 | BFG520 (/X)(/XR) | | BFS520 | BFG520W (/X)(/XR) | BFC520 BFE520 | BFM520 |
| (21) | | BFR540 | BFG540 (/X)(/XR) | BFG541 | BFS540 | BFG540W (/X)(/XR) | | |
| (22) | | | BFG590 (/X)(/XR) | BFG591 | | BFG590W (/X)(/XR) | | |
| (23) | BFQ621 | | BFG10(/X) | | | BFG10W/X | | |
| (24) | | | BFG11(/X) | | | BFG11W/X | | |

Note

- SOT143 and SOT343 packages are available with alternative pinning.
European pinning - no type number suffix; USA pinning - suffix /X; Japanese pinning - suffix /XR.
Brackets around the suffixes (/X) and (/XR) denote pinning options. No brackets means no options,
(e.g. BFG10W/X: only available with USA pinning).

FIFTH GENERATION NPN WIDEBAND TRANSISTORS (f_T up to 25 GHz)

| f_T / I_C CURVE (see Fig.1) | PACKAGE |
|----------------------------------|---------------|
| | SURFACE-MOUNT |
| | SOT343 |
| (25) | BFG403W |
| (26) | BFG410W |
| (27) | BFG425W |
| (28) | BFG21W |

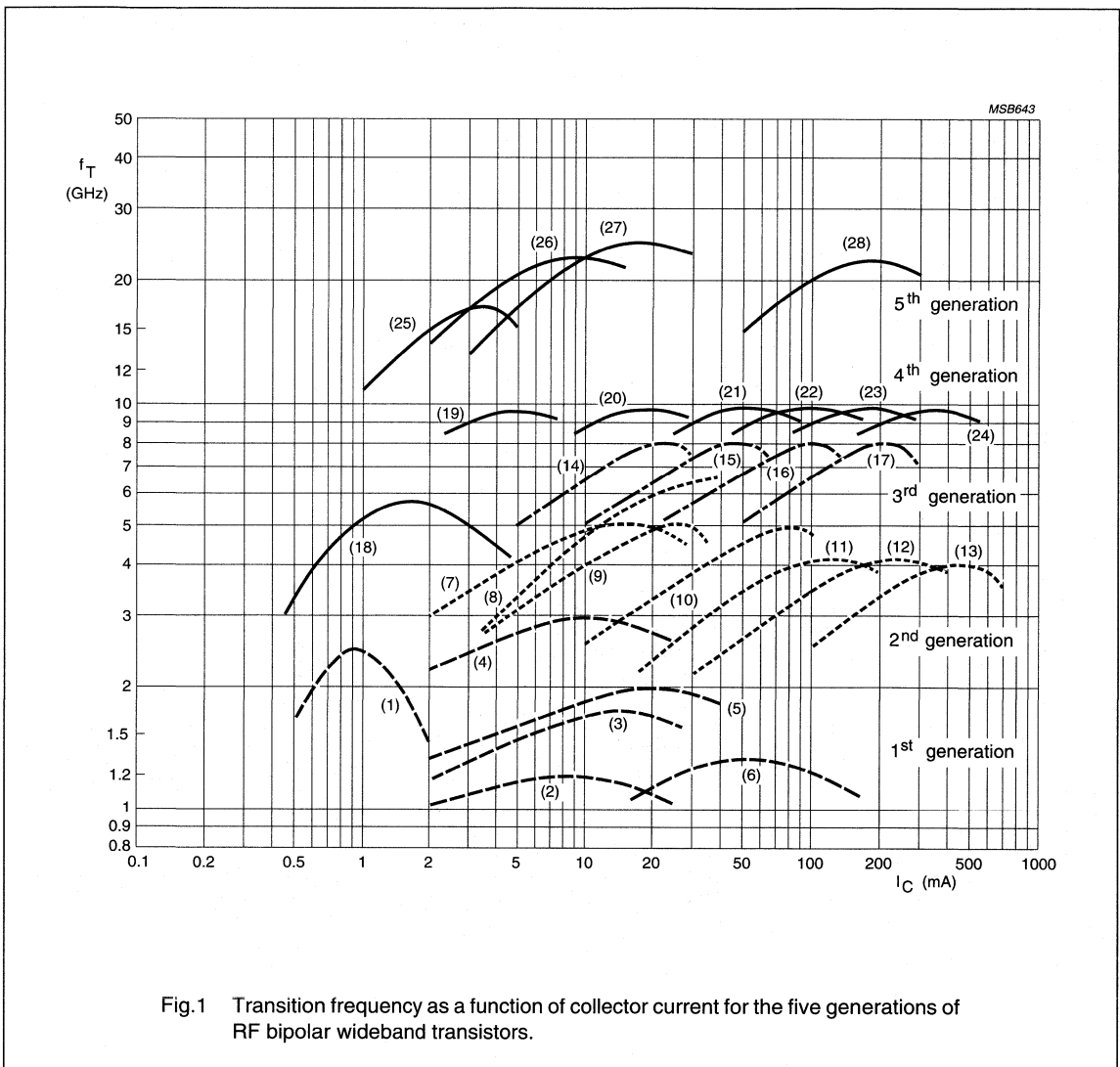


Fig.1 Transition frequency as a function of collector current for the five generations of RF bipolar wideband transistors.

RF Wideband Transistors

Selection guide

PRODUCT DATA

| TYPE NUMBER | f_T / I_C CURVE (see Fig.1) | POLARITY | PACKAGE | RATINGS | | |
|------------------|----------------------------------|----------|---------|-------------------|---------------|-------------------|
| | | | | V_{CE0} (V) | I_C (mA) | P_{tot} (mW) |
| BF547 | (2) | NPN | SOT23 | 20 | 50 | 300 |
| BF547W | (2) | NPN | SOT323 | 20 | 50 | 300 |
| BF689K | (3) | NPN | SOT54 | 15 | 25 | 360 |
| BF747 | (2) | NPN | SOT23 | 20 | 50 | 300 |
| BF763 | (3) | NPN | SOT54 | 25 | 25 | 360 |
| BFC505 | (19) | NPN | SOT353 | 8 | 18 | 500 |
| BFC520 | (20) | NPN | SOT353 | 8 | 70 | 1000 |
| BFE505 | (19) | NPN | SOT353 | 8 | 18 | 500 |
| BFE520 | (20) | NPN | SOT353 | 8 | 70 | 1000 |
| BFG10(/X) | (23) | NPN | SOT143 | 8 | 250 | 250 |
| BFG10W/X | (23) | NPN | SOT343 | 10 | 250 | 400 |
| BFG11(/X) | (24) | NPN | SOT143 | 8 | 500 | 400 |
| BFG11W/X | (24) | NPN | SOT343 | 8 | 500 | 760 |
| BFG16A | (6) | NPN | SOT223 | 25 | 150 | 1000 |
| BFG17A | (4) | NPN | SOT143 | 15 | 50 | 300 |
| BFG25A/X | (18) | NPN | SOT143 | 5 | 6.5 | 32 |
| BFG25AW(/X)(/XR) | (18) | NPN | SOT343 | 5 | 6.5 | 500 |
| BFG31 | (10) | PNP | SOT223 | 15 | 100 | 1000 |
| BFG35 | (11) | NPN | SOT223 | 18 | 150 | 1000 |
| BFG67(/X)(/XR) | (14) | NPN | SOT143 | 10 | 50 | 380 |
| BFG92A(/X)(/XR) | (7) | NPN | SOT143 | 15 | 25 | 400 |
| BFG93A(/X)(/XR) | (8) | NPN | SOT143 | 12 | 35 | 300 |
| BFG94 | (8) | NPN | SOT223 | 12 | 60 | 700 |
| BFG97 | (10) | NPN | SOT223 | 15 | 100 | 1000 |
| BFG135 | (16) | NPN | SOT223 | 15 | 150 | 1000 |
| BFG197(/X)(/XR) | (15) | NPN | SOT143 | 10 | 100 | 350 |
| BFG198 | (15) | NPN | SOT223 | 10 | 100 | 1000 |
| BFG403W | (25) | NPN | SOT343 | 4.5 | 3.6 | 16 |
| BFG410W | (26) | NPN | SOT343 | 4.5 | 12 | 54 |
| BFG425W | (27) | NPN | SOT343 | 4.5 | 30 | 135 |
| BFG505(/X)(/XR) | (19) | NPN | SOT143 | 15 ⁽¹⁾ | 18 | 150 |
| BFG505W(/X)(/XR) | (19) | NPN | SOT343 | 15 ⁽¹⁾ | 18 | 500 |
| BFG520(/X)(/XR) | (20) | NPN | SOT143 | 15 ⁽¹⁾ | 70 | 300 |

Note

1. V_{CES} .

PRODUCT DATA

| TYPE NUMBER | CHARACTERISTICS, typical values | | | | | | | | | | | |
|-----------------|---------------------------------|-----------|----------------------|--------------|-----------|---------------------|--------------|---------------------|----------------|--------------|-----------------|-------------------|
| | f_T (GHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | $V_o^{(1)}$ (mV) | P_L (dBm) | ITO (dBm) | @ I_C (mA) | & V_{CE} (V) |
| BF547 | 1.2 | | 20 | 100 | | | | | | | | |
| BF547W | 1.2 | | 20 | 100 | | | | | | | | |
| BF689K | 1.8 | 4 | | 100 | 3 | 16 ⁽³⁾ | 200 | | | | | |
| BF747 | 1.2 | | 20 | 100 | | | | | | | | |
| BF763 | 1.8 | 5 | | 800 | | | | | | | | |
| BFC505 | 7.3 | 1.8 | | 900 | 3.5 | | 2000 | | | | | |
| BFC520 | 7 | 1.3 | | 900 | | | | | | | | |
| BFE505 | 9 | 1.2 | | 900 | 1.9 | | 2000 | | | | | |
| BFE520 | 9 | 1.1 | | 900 | 1.9 | | 2000 | | | | | |
| BFG10(X) | | | 7 ⁽³⁾ | 1900 | | | | | | | | |
| BFG10W/X | | | 10 ⁽²⁾⁽³⁾ | 900 | | 7 ⁽³⁾ | 1900 | | | | | |
| BFG11(X) | | | 5 ⁽³⁾ | 1900 | | | | | | | | |
| BFG11W/X | | | | | | 6 ⁽²⁾⁽³⁾ | 1900 | | | | | |
| BFG16A | 1.5 | | 10 | 500 | | | | | | | | |
| BFG17A | 2.8 | 2.5 | 15 | 800 | | | | | | | | |
| BFG25A/X | 5 | 1.8 | 18 | 1000 | | | | | | | | |
| BFG25AW(X)/(XR) | 5 | 2 | 16 | 1000 | | | | | | | | |
| BFG31 | 5 | | 16 | 500 | | 12 | 800 | 550 | | | 70 | 10 |
| BFG35 | 4 | | 15 | 500 | | 11 | 800 | 750 | | | 100 | 10 |
| BFG67(X)/(XR) | 8 | 1.7 | 17 | 1000 | 2.5 | 10 | 2000 | | | | | |
| BFG92A(X)/(XR) | 5 | 2 | 16 | 1000 | 3 | 11 | 2000 | | | | | |
| BFG93A(X)/(XR) | 6 | 1.7 | 16 | 1000 | 2.3 | 10 | 2000 | | | | | |
| BFG94 | 6 | 2.7 | | 500 | 3 | 13.5 | 1000 | 500 | 21.5 | 34 | 45 | 10 |
| BFG97 | 5.5 | 2 | 16 | 500 | | 12 | 800 | 700 | | | 70 | 10 |
| BFG135 | 7 | | 16 | 500 | | 12 | 800 | 850 | | | 100 | 10 |
| BFG197(X)/(XR) | 7.5 | 2.3 | 16 | 1000 | | 10 | 2000 | | | | | |
| BFG198 | 8 | | 18 | 500 | | 15 | 800 | 700 | | | 70 | 8 |
| BFG403W | 17 | 1 | | 900 | 1.6 | | 2000 | | | 6 | 1 | 1 |
| BFG410W | 22 | 0.9 | | 900 | 1.2 | | 2000 | | | 15 | 10 | 2 |
| BFG425W | 25 | 0.8 | | 900 | 1.2 | | 2000 | | | 22 | 25 | 2 |
| BFG505(X)/(XR) | 9 | 1.6 | 20 | 900 | 1.9 | 13 | 2000 | | 4 | 10 | 5 | 6 |
| BFG505W(X)/(XR) | 9 | 1.6 | 19 | 900 | 1.9 | 12 | 2000 | | 4 | 10 | 5 | 6 |
| BFG520(X)/(XR) | 9 | 1.6 | 19 | 900 | 1.9 | 13 | 2000 | 275 | 17 | 26 | 20 | 6 |

Notes

1. At $d_{im} = -60$ dB, measured according to DIN45004B, par. 6.3: 3-tone test.
2. Minimum value.
3. Power gain G_p .

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Selection guide

PRODUCT DATA

| TYPE NUMBER | f_T / I_C CURVE (see Fig.1) | POLARITY | PACKAGE | RATINGS | | |
|-----------------|---------------------------------------|----------|---------|-------------------|---------------|-------------------|
| | | | | V_{CE0} (V) | I_C (mA) | P_{tot} (mW) |
| BFG520W(X)/(XR) | (20) | NPN | SOT343 | 15 ⁽¹⁾ | 70 | 500 |
| BFG540(X)/(XR) | (21) | NPN | SOT143 | 15 ⁽¹⁾ | 120 | 500 |
| BFG540W(X)/(XR) | (21) | NPN | SOT343 | 15 ⁽¹⁾ | 120 | 500 |
| BFG541 | (21) | NPN | SOT223 | 15 ⁽¹⁾ | 120 | 650 |
| BFG590(X)/(XR) | (22) | NPN | SOT143 | 15 | 200 | 400 |
| BFG590W(X)/(XR) | (22) | NPN | SOT343 | 15 | 200 | 500 |
| BFG591 | (22) | NPN | SOT223 | 15 | 200 | 2000 |
| BFM505 | (19) | NPN | SOT363 | 8 | 18 | 500 |
| BFM520 | (20) | NPN | SOT363 | 8 | 70 | 1000 |

Note

1. V_{CES} .

PRODUCT DATA

| TYPE NUMBER | CHARACTERISTICS, typical values | | | | | | | | | | | |
|------------------|---------------------------------|-----------|------------------|--------------|-----------|------------------|--------------|---------------------|----------------|--------------|-----------------|-------------------|
| | f_T (GHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | $V_o^{(1)}$ (mV) | P_L (dBm) | ITD (dBm) | @ I_C (mA) | & V_{CE} (V) |
| BFG520W(/X)(/XR) | 9 | 1.6 | 17 | 900 | 1.85 | 11 | 2000 | 275 | 17 | 26 | 20 | 6 |
| BFG540(/X)(/XR) | 9 | 1.9 | 18 | 900 | 2.1 | 11 | 2000 | 500 | 21 | 34 | 40 | 8 |
| BFG540W(/X)(/XR) | 9 | 1.9 | 16 | 900 | 2.1 | 10 | 2000 | 500 | 21 | 34 | 40 | 8 |
| BFG541 | 9 | 1.9 | 15 | 900 | 2.1 | 9 | 2000 | 500 | 21 | 34 | 40 | 8 |
| BFG590(/X)(/XR) | 5 | | 13 | 900 | | 7.5 | 2000 | | | | | |
| BFG590W(/X)(/XR) | 5 | | 13 | 900 | | 7.5 | 2000 | | 21 | | 80 | 5 |
| BFG591 | 7 | | 13 | 900 | | 7.5 | 2000 | | | | | |
| BFM505 | 9 | 1.4 | 17 | 900 | 1.9 | 10 | 2000 | | | | | |
| BFM520 | 9 | 1.7 | 15 | 900 | 1.9 | 9 | 2000 | | | | | |

Note

1. At $d_{im} = -60$ dB, measured according to DIN45004B, par. 6.3: 3-tone test.

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PRODUCT DATA

| TYPE NUMBER | f_T / I_C CURVE (see Fig.1) | POLARITY | PACKAGE | RATINGS | | |
|----------------|-------------------------------------|----------|---------|-------------------|---------------|-------------------|
| | | | | V_{CE0} (V) | I_C (mA) | P_{tot} (mW) |
| BFQ17 | (6) | NPN | SOT89 | 25 | 150 | 1000 |
| BFQ18A | (11) | NPN | SOT89 | 18 | 150 | 1000 |
| BFQ19 | (10) | NPN | SOT89 | 15 | 100 | 1000 |
| BFQ34 | (11) | NPN | SOT122 | 18 | 150 | 2700 |
| BFQ67 | (14) | NPN | SOT23 | 10 | 50 | 300 |
| BFQ67W | (14) | NPN | SOT323 | 10 | 50 | 300 |
| BFQ68 | (12) | NPN | SOT122 | 18 | 300 | 4500 |
| BFQ135 | (16) | NPN | SOT172 | 19 | 150 | 2700 |
| BFQ136 | (13) | NPN | SOT122 | 18 | 600 | 9000 |
| BFQ149 | (10) | PNP | SOT89 | 15 | 100 | 1000 |
| BFQ270 | (17) | NPN | SOT172 | 19 | 500 | 10000 |
| BFQ540 | (21) | NPN | SOT89 | 12 | 120 | 1200 |
| BFQ621 | (23) | NPN | SOT172 | 16 | 150 | 800 |
| BFR53 | (5) | NPN | SOT23 | 10 | 50 | 250 |
| BFR92 | (7) | NPN | SOT23 | 15 | 25 | 300 |
| BFR92A | (7) | NPN | SOT23 | 15 | 25 | 300 |
| BFR92AW | (7) | NPN | SOT323 | 15 | 25 | 300 |
| BFR93 | (8) | NPN | SOT23 | 12 | 35 | 300 |
| BFR93A | (8) | NPN | SOT23 | 12 | 35 | 300 |
| BFR93AW | (8) | NPN | SOT323 | 12 | 35 | 300 |
| BFR94A | (8) | NPN | SOT122 | 25 | 150 | 3500 |
| BFR106 | (10) | NPN | SOT23 | 15 | 100 | 500 |
| BFR505 | (19) | NPN | SOT23 | 15 ⁽¹⁾ | 18 | 150 |
| BFR520 | (20) | NPN | SOT23 | 15 ⁽¹⁾ | 70 | 300 |
| BFR540 | (21) | NPN | SOT23 | 15 ⁽¹⁾ | 120 | 480 |
| BFS17 | (3) | NPN | SOT23 | 15 | 25 | 300 |
| BFS17A | (4) | NPN | SOT23 | 15 | 25 | 300 |
| BFS17W | (3) | NPN | SOT323 | 15 | 50 | 300 |
| BFS25A | (18) | NPN | SOT323 | 5 | 6.5 | 32 |
| BFS505 | (19) | NPN | SOT323 | 15 ⁽¹⁾ | 18 | 150 |
| BFS520 | (20) | NPN | SOT323 | 15 ⁽¹⁾ | 70 | 300 |
| BFS540 | (21) | NPN | SOT323 | 15 ⁽¹⁾ | 120 | 500 |
| BFT25 | (1) | NPN | SOT23 | 5 | 6.5 | 30 |
| BFT25A | (18) | NPN | SOT23 | 5 | 6.5 | 32 |
| BFT92 | (7) | PNP | SOT23 | 15 | 25 | 300 |
| BFT92W | (7) | PNP | SOT323 | 15 | 35 | 300 |
| BFT93 | (9) | PNP | SOT23 | 12 | 35 | 300 |

Note

1. V_{CES} .

PRODUCT DATA

| TYPE NUMBER | CHARACTERISTICS, typical values | | | | | | | | | | | |
|----------------|---------------------------------|------------------|------------------|--------------|-----------|------------------|--------------|---------------------|----------------|--------------|-----------------|-------------------|
| | f_T (GHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | $V_o^{(1)}$ (mV) | P_L (dBm) | ITO (dBm) | @ I_C (mA) | & V_{CE} (V) |
| BFQ17 | 1.5 | | 16 | 200 | | 6.5 | 800 | | | | | |
| BFQ18A | 4 | | | | | | | | | | | |
| BFQ19 | 5.5 | 3.3 | 11.5 | 500 | | 7.5 | 800 | | | | | |
| BFQ34 | 4 | 8 | 16.3 | 500 | | | | 1200 | 26 | 45 | 120 | 15 |
| BFQ67 | 8 | 1.7 | 14 | 1000 | 2.7 | 8 | 2000 | | | | | |
| BFQ67W | 8 | 2 | 13 | 1000 | 2.7 | 8 | 2000 | | | | | |
| BFQ68 | 4 | | 13 | 800 | | | | 1600 | 28 | 47 | 240 | 15 |
| BFQ135 | 6.5 | | 17 | 500 | | 13.5 | 800 | 1200 | | | 120 | 18 |
| BFQ136 | 4 | | 12.5 | 800 | | | | 2500 | | | 500 | 15 |
| BFQ149 | 5 | 3.75 | 12 | 500 | | | | | | | | |
| BFQ270 | 6 | | 16 | 500 | | 10 | 1000 | 1600 | | | 240 | 18 |
| BFQ540 | 9 | 1.9 | | 900 | | | | 500 | | | 40 | 8 |
| BFQ621 | 7 | | 18.5 | 500 | | | | 1200 | | | 120 | 18 |
| BFR53 | 2 | 5 ⁽²⁾ | | 500 | | 10.5 | 800 | | | | | |
| BFR92 | 5 | 2.4 | 18 | 500 | | | | 150 | | | 14 | 10 |
| BFR92A | 5 | 2.1 | 14 | 1000 | 3 | 8 | 2000 | 150 | | | 14 | 10 |
| BFR92AW | 5 | 2 | 14 | 1000 | 3 | 8 | 2000 | | | | | |
| BFR93 | 5 | 1.9 | 16.5 | 500 | | | | | | | | |
| BFR93A | 6 | 1.9 | 13 | 1000 | 3 | 7 | 2000 | 425 | | | 30 | 8 |
| BFR93AW | 5 | 1.5 | 13 | 1000 | 2.1 | 8 | 2000 | | | | | |
| BFR94A | 3.5 | 8 | | 200 | 5 | 13.5 | 500 | | | | | |
| BFR106 | 5 | 3.5 | 11.5 | 800 | | | | 350 | | | 50 | 9 |
| BFR505 | 9 | 1.6 | 17 | 900 | 1.9 | 10 | 2000 | | 4 | 10 | 5 | 6 |
| BFR520 | 9 | 1.6 | 15 | 900 | 1.9 | 9 | 2000 | | 17 | 26 | 20 | 6 |
| BFR540 | 9 | 1.9 | 14 | 900 | 2.1 | 7 | 2000 | 550 | 21 | 34 | 40 | 8 |
| BFS17 | 1 | 4.5 | | 500 | | | | | | | | |
| BFS17A | 2.8 | 2.5 | 13.5 | 800 | | | | 150 | | | 14 | 10 |
| BFS17W | 1.6 | 4.5 | | 500 | | | | | | | | |
| BFS25A | 5 | 1.8 | 13 | 1000 | | | | | | | | |
| BFS505 | 9 | 1.6 | 17 | 900 | 1.9 | 10 | 2000 | | 4 | 10 | 5 | 6 |
| BFS520 | 9 | 1.6 | 15 | 900 | 1.9 | 9 | 2000 | | 17 | 26 | 20 | 6 |
| BFS540 | 9 | 1.9 | 14 | 900 | 2.1 | 8 | 2000 | | 21 | 34 | 40 | 8 |
| BFT25 | 2.3 | 3.8 | 18 | 500 | | 12 | 800 | | | | | |
| BFT25A | 5 | 1.8 | 15 | 1000 | | | | | | | | |
| BFT92 | 5 | 2.5 | 18 | 500 | | | | 150 | | | 14 | 10 |
| BFT92W | 5 | 2.5 | 17 | 500 | 3 | 11 | 1000 | | | | | |
| BFT93 | 5 | 2.4 | 16.5 | 500 | | | | 300 | | | 30 | 5 |

Notes

1. At $d_{im} = -60$ dB, measured according to DIN45004B, par. 6.3: 3-tone test.
2. Maximum value.

RF Wideband Transistors

Selection guide

PRODUCT DATA

| TYPE NUMBER | f_T / I_C CURVE (see Fig.1) | POLARITY | PACKAGE | RATINGS | | |
|-------------|-------------------------------------|----------|---------|------------------|---------------|-------------------|
| | | | | V_{CE0} (V) | I_C (mA) | P_{tot} (mW) |
| BFT93W | (9) | PNP | SOT323 | 12 | 50 | 300 |
| MPSH10 | | NPN | SOT54 | 25 | 40 | 1000 |
| PMBT3640 | | PNP | SOT23 | 12 | 80 | 350 |
| PMBTH10 | | NPN | SOT23 | 25 | 40 | 400 |
| PMBTH81 | | PNP | SOT23 | 20 | 40 | 400 |

DEVELOPMENT TYPES

| TYPE NUMBER | f_T / I_C CURVE (see Fig.1) | POLARITY | PACKAGE | RATINGS | | |
|-------------|-------------------------------------|----------|---------|------------------|--------------------|-------------------|
| | | | | V_{CE0} (V) | I_C (mA) | P_{tot} (mW) |
| BFG21W | (28) | NPN | SOT343 | 4.5 | 200 ⁽¹⁾ | 600 |

Note

1. Typical value.

RF Wideband Transistors

Selection guide

PRODUCT DATA

| TYPE NUMBER | CHARACTERISTICS, typical values | | | | | | | | | | | |
|-------------|---------------------------------|-----------|------------------|--------------|-----------|------------------|--------------|---------------------|----------------|--------------|-----------------|-------------------|
| | f_T (GHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | $V_o^{(1)}$ (mV) | P_L (dBm) | ITO (dBm) | @ I_C (mA) | & V_{CE} (V) |
| BFT93W | 5 | 2.4 | 15.5 | 500 | 3 | 10 | 1000 | | | | | |
| MPSH10 | 0.65 ⁽²⁾ | | | | | | | | | | | |
| PMBT3640 | 0.5 ⁽²⁾ | | | | | | | | | | | |
| PMBTH10 | 0.65 ⁽²⁾ | | | | | | | | | | | |
| PMBTH81 | 0.6 ⁽²⁾ | | | | | | | | | | | |

Notes

1. At $d_{im} = -60$ dB, measured according to DIN45004B, par. 6.3: 3-tone test.
2. Minimum value.

DEVELOPMENT TYPES

| TYPE NUMBER | CHARACTERISTICS, typical values | | | | | | | | | | | |
|-------------|---------------------------------|-----------|----------------------|--------------|-----------|------------------|--------------|---------------------|----------------|--------------|-----------------|-------------------|
| | f_T (GHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | F (dB) | G_{UM} (dB) | @ f (MHz) | $V_o^{(1)}$ (mV) | P_L (dBm) | ITO (dBm) | @ I_C (mA) | & V_{CE} (V) |
| BFG21W | 18 ⁽²⁾ | | 10 ⁽²⁾⁽³⁾ | 1900 | | | | | | | | |

Notes

1. At $d_{im} = -60$ dB, measured according to DIN45004B, par. 6.3: 3-tone test.
2. Minimum value.
3. Power gain G_p .

RF Wideband Transistors

Selection guide

LINE-UPS

Analog cellular (AMPS, (E)TACS, NMT) 900 MHz

| INPUT POWER (mW) | 1 st STAGE | 2 nd STAGE | 3 rd STAGE | P _L (W) | SUPPLY VOLTAGE (V) |
|------------------|-----------------------|-----------------------|-----------------------|--------------------|--------------------|
| Bipolar | | | | | |
| 1 | BFG540/X | BLT80 | BLT81 | 1.2 | 6 |
| 1 | BFG540/X | BLT70 | BLT71 | 1.2 | 4.8 |
| 1 | BFG10W/X | BLT71/8 | – | 1.2 | 4.8 |

Digital cellular (GSM) 900 MHz

| INPUT POWER (mW) | 1 st STAGE | 2 nd STAGE | 3 rd STAGE | P _L (W) | SUPPLY VOLTAGE (V) |
|------------------|-----------------------|-----------------------|-----------------------|--------------------|--------------------|
| Bipolar | | | | | |
| 1 | BFG540W/X | BFG10W/X | BLT82 | 3.5 pulsed | 6 |

Portable transmitters (860 MHz to 960 MHz)

| INPUT POWER (mW) | 1 st STAGE | 2 nd STAGE | 3 rd STAGE | P _L (W) | SUPPLY VOLTAGE (V) |
|------------------|-----------------------|-----------------------|-----------------------|--------------------|--------------------|
| Bipolar | | | | | |
| 1 | BFG540 | BLT80 | BLT81 | 1.2 | 6 |
| 15 | BFG93A | BLT80 | BLT92/SL | 3 | 7.5 |

RF wideband transmitters for pager front-end (see Fig.2)

| FUNCTION | TYPE NUMBER | REMARKS |
|-----------------------------|-------------|--|
| RF amplifier | BFC505 | higher gain, lower noise, high isolation (0.3 mA) |
| | BFG403W | high performance, low voltage, low current |
| | BFR505 | higher gain, lower noise (1 mA) |
| | BFT25A | lowest current (0.2 mA) |
| Oscillator, mixer or buffer | BFQ67 | choice of the transistor is determined by the available current and the required performance |
| | BFR92A | |
| | BFR505 | |
| | BFT25A | |

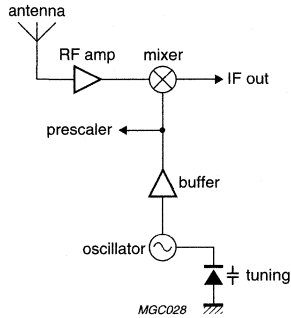


Fig.2 Typical front-end section for pagers.

RF Wideband Transistors

Selection guide

RF wideband transistors for the receiver section in cordless/cellular phones (see Fig.3)

| FUNCTION | TYPE NUMBER | SYSTEM FREQUENCY (MHz) | FEATURES |
|----------------|-------------|------------------------|---|
| LNA | BFC505 | 1900 | high isolation gain, low noise current |
| | BFG410W | 900; 1900; 2500 | very low noise |
| | BFG425W | 900; 1900; 2500 | very low noise |
| | BFR505 | 900; 1900 | good performance at low current (1 mA) |
| | BFR520 | 900; 1900 | higher gain, lower noise (10 mA) |
| Mixer | BFE505 | 900; 1900 | balanced mixer in a single SOT353 package |
| | BFG505 | 900; 1900 | good performance, low current |
| | BFG410W | 900; 1900; 2500 | low noise, high isolation |
| | BFG520 | 900; 1900 | higher power to IF (10 mA) |
| | BFR93A | 900 | low cost, acceptable performance |
| Buffer and VCO | BFG410W | 900; 1900; 2500 | excellent isolation |
| | BFG505 | 1900 | buffer and VCO in a single SOT353 package |
| | BFQ67 | 900 | third generation, good performance |
| | BFR92A | 900 | excellent VCO, good buffer, low-cost |
| | BFR93A | 900 | excellent VCO, good buffer, low-cost |
| | BFR505 | 900; 1900 | good VCO, high-gain buffer, low current |
| | BFR520 | 900; 1900 | good VCO, higher output power |
| IF | BFS17A | 40 to 100 | any first or second generation transistor |

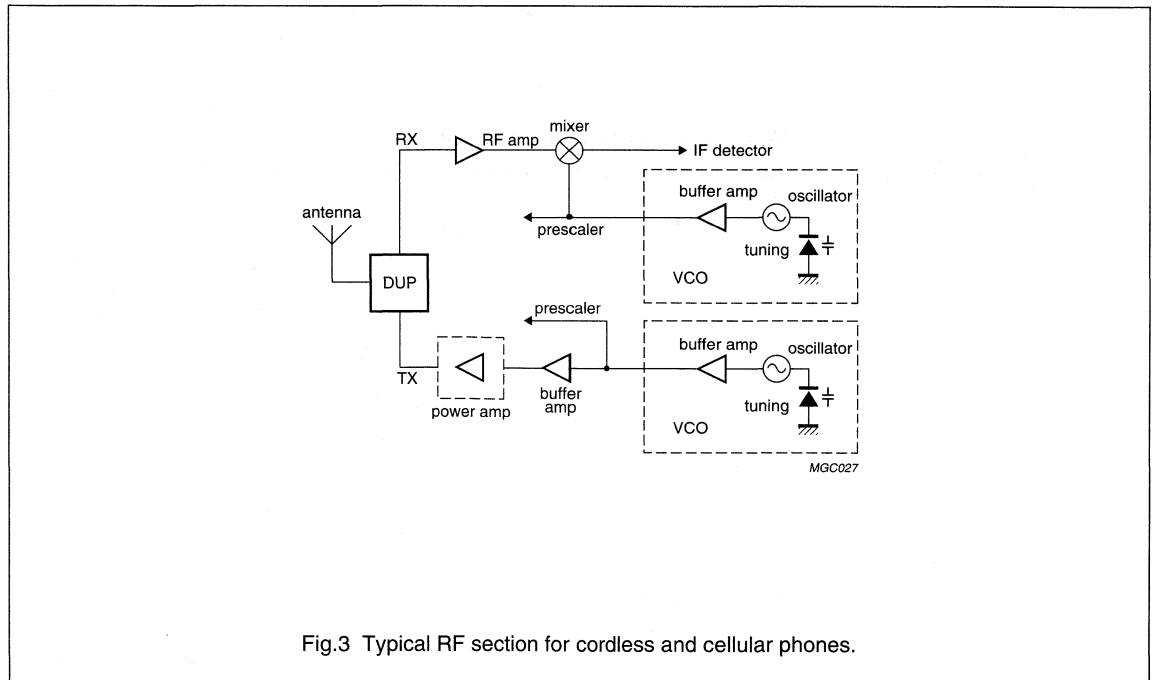


Fig.3 Typical RF section for cordless and cellular phones.

RF Wideband Transistors

Selection guide

RF wideband transistors for the receiver section in cordless/cellular phones (see Fig.3)

| FUNCTION | SYSTEM FREQUENCY (MHz) | SOT23 | SOT323 | SOT143 ⁽¹⁾ | SOT343 ⁽¹⁾ | SOT353 | SOT363 |
|-------------------|------------------------------|---------|---------|-----------------------|-----------------------|--------|--------|
| LNA | 900; 1900 | BFR505 | BFS505 | BFG505 | BFG505W | BFC505 | BFM505 |
| | 900; 1900 | BFR 520 | BFS520 | BFG520 | BFG520W | BFC520 | BFM520 |
| Mixer | 900 | BFR93A | BFR93AW | BFG93A | | | |
| | 900; 1900 | BFR505 | BFS505 | BFG505 | BFG505W | BFE505 | BFM505 |
| | 900; 1900 | BFR520 | BFS520 | BFG520 | BFG520W | BFE520 | BFM520 |
| Buffer and VCO | 900 | BFR92A | BFR92AW | BFG92A | | | |
| | 900 | BFR93A | BFR93AW | BFG93A | | | |
| | 900 | BFQ67 | BFQ67W | BFG67 | | | |
| | 900; 1900 | BFR505 | BFS505 | BFG505 | BFG505W | BFC505 | BFM505 |
| | 900; 1900 | BFR520 | BFS520 | BFG520 | BFG520W | BFC520 | BFM520 |
| IF | 40 to 100 | BF547 | BF547W | | | | |
| | | BFS17 | BFS17W | BFG17A | | | |
| | | BFR92A | BFR92AW | BFG92A | | | |

Note

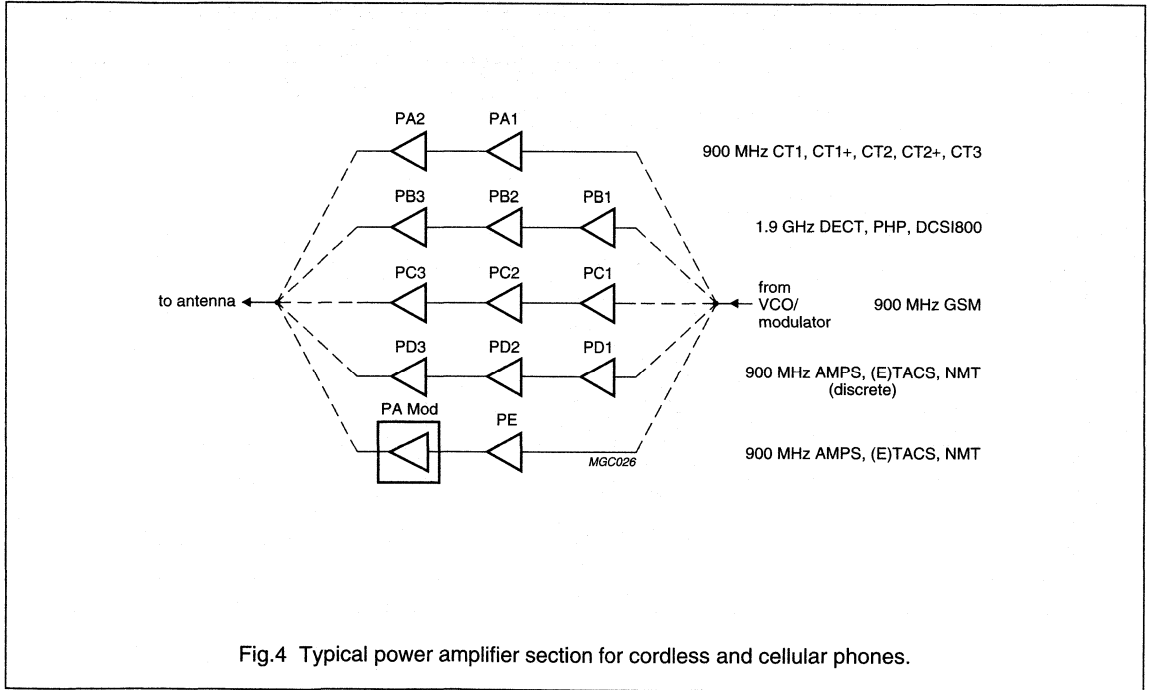
1. Also available in /X and /XR versions.

RF Wideband Transistors

Selection guide

RF wideband transistors for the power amplifier section in cordless/cellular phones (see Fig.4)

| SYSTEM | SUPPLY VOLTAGE (V) | P _{out} (mW) | SOT143 | SOT343 |
|---------------------------------|--------------------|-----------------------|----------|-----------|
| CT1, CT1+, CT2, CT2+, CT3 | 3.3 | driver for PA2 | BFG67 | |
| | | | BFG505 | BFG505W |
| | | | BFG520 | BFG520W |
| | | 15 | BFG67 | |
| | | 20 | BFG520 | BFG520W |
| DECT, PHP | 3.3 | 400 | BFG540/X | BFG540W/X |
| | | | BFG10/X | BFG10W/X |
| | | | BFG11/X | BFG11W/X |



RF Wideband Transistors

Replacement list

REPLACED/WITHDRAWN TYPES

The following type numbers were included in the previous issue of this data handbook, but are not in the current edition.

| TYPE NUMBER | REASON FOR DELETION |
|-------------|---|
| BFC540 | Development stopped. Replaced by BFC520 |
| BFG67W | Discontinued. Replaced by BFG67 |
| BFG67W/X | Discontinued. Replaced by BFG67/X |
| BFG67W/XR | Discontinued Replaced by BFG67/XR |
| BFG92AW | Discontinued. Replaced by BFG92A |
| BFG92AW/X | Discontinued. Replaced by BFG92A/X |
| BFG92AW/XR | Discontinued. Replaced by BFG92A/XR |
| BFG93AW | Discontinued. Replaced by BFG93A |
| BFG93AW/X | Discontinued. Replaced by BFG93A/X |
| BFG93AW/XR | Discontinued. Replaced by BFG93A/XR |
| BFG197W | Discontinued. Replaced by BFG197 |
| BFG197W/X | Discontinued. Replaced by BFG197/X |
| BFG197W/XR | Discontinued Replaced by BFG197/XR |
| BFM540 | Discontinued. Replaced by BFM520 |
| BFP91A | Discontinued |
| BFP96 | Discontinued |
| BFQ66 | Discontinued |
| BFE540 | Development stopped. Replaced by BFE520 |
| BFY90 | Discontinued |
| BFX89 | Discontinued |
| BFW30 | Discontinued |
| BFQ53 | Discontinued |
| BFQ22S | Discontinued |
| BFQ63 | Discontinued |
| BFQ52 | Discontinued |
| BFQ24 | Discontinued |
| BFW16A | Discontinued |
| BFR95 | Discontinued |

RF Wideband Transistors

Marking codes

TYPE NUMBER TO PACKAGE AND MARKING CODE

| TYPE NUMBER | PACKAGE | MARKING CODE |
|-------------|---------|--------------|
| BF547 | SOT23 | E16 |
| BF547W | SOT323 | E2 |
| BF689K | SOT54 | F689K |
| BF747 | SOT23 | E15 |
| BF763 | SOT54 | F763 |
| BFC505 | SOT353 | N0 |
| BFC520 | SOT353 | N3 |
| BFE505 | SOT353 | P0 |
| BFE520 | SOT353 | N5 |
| BFG10 | SOT143 | N70 |
| BFG10/X | SOT143 | N71 |
| BFG10W/X | SOT343 | T5 |
| BFG11 | SOT143 | N72 |
| BFG11/X | SOT143 | N73 |
| BFG11W/X | SOT343 | S4 |
| BFG16A | SOT223 | BFG16A |
| BFG17A | SOT143 | E6p |
| BFG21W | SOT343 | P1 |
| BFG25A/X | SOT143 | V11 |
| BFG25AW | SOT343 | N6 |
| BFG25AW/X | SOT343 | V1 |
| BFG25AW/XR | SOT343 | V3 |
| BFG31 | SOT223 | BFG31 |
| BFG35 | SOT223 | BFG35 |
| BFG403W | SOT343 | P3 |
| BFG410W | SOT343 | P4 |
| BFG425W | SOT343 | P5 |
| BFG67 | SOT143 | V3p |
| BFG67R | SOT143 | V27 |
| BFG67/X | SOT143 | V12 |
| BFG67/XR | SOT143 | V26 |
| BFG92A | SOT143 | P8 |
| BFG92A/X | SOT143 | V14 |
| BFG92A/XR | SOT143 | V29 |
| BFG93A | SOT143 | R8p |
| BFG93A/X | SOT143 | V15 |
| BFG93A/XR | SOT143 | V33 |
| BFG94 | SOT223 | BFG94 |
| BFG97 | SOT223 | BFG97 |
| BFG135 | SOT223 | BFG135 |
| BFG197 | SOT143 | V5p |

| TYPE NUMBER | PACKAGE | MARKING CODE |
|-------------|---------|--------------|
| BFG197/X | SOT143 | V13 |
| BFG197/XR | SOT143 | V35 |
| BFG198 | SOT223 | BFG198 |
| BFG505 | SOT143 | N33 |
| BFG505/X | SOT143 | N39 |
| BFG505/XR | SOT143 | N45 |
| BFG505W | SOT343 | N0 |
| BFG505W/X | SOT343 | N1 |
| BFG505W/XR | SOT343 | P0 |
| BFG520 | SOT143 | N36 |
| BFG520/X | SOT143 | N42 |
| BFG520/XR | SOT143 | N48 |
| BFG520W | SOT343 | N3 |
| BFG520W/X | SOT343 | N4 |
| BFG520W/XR | SOT343 | N5 |
| BFG540 | SOT143 | N37 |
| BFG540/X | SOT143 | N43 |
| BFG540/XR | SOT143 | N49 |
| BFG540W | SOT343 | N9 |
| BFG540W/X | SOT343 | N7 |
| BFG540W/XR | SOT343 | N8 |
| BFG541 | SOT223 | BFG541 |
| BFG590 | SOT143 | N38 |
| BFG590/X | SOT143 | N44 |
| BFG590/XR | SOT143 | N50 |
| BFG590W | SOT343 | T1 |
| BFG590W/X | SOT343 | T2 |
| BFG590W/XR | SOT343 | T3 |
| BFG591 | SOT223 | BFG591 |
| BFM505 | SOT363 | N0 |
| BFM520 | SOT363 | N2 |
| BFQ17 | SOT89 | FA |
| BFQ18A | SOT89 | FF |
| BFQ19 | SOT89 | FB |
| BFQ34 | SOT122E | BFQ34/01 |
| BFQ67 | SOT23 | V2p |
| BFQ67W | SOT323 | V2 |
| BFQ68 | SOT122E | BFQ68 |
| BFQ135 | SOT172 | BFQ135 |
| BFQ136 | SOT122E | BFQ136 |
| BFQ149 | SOT89 | FG |
| BFQ270 | SOT172 | BFQ270 |

RF Wideband Transistors

Marking codes

| TYPE NUMBER | PACKAGE | MARKING CODE |
|-------------|---------|--------------|
| BFQ540 | SOT89 | N4 |
| BFQ621 | SOT172 | BFQ621 |
| BFR53 | SOT23 | N1p |
| BFR92 | SOT23 | P1p |
| BFR92A | SOT23 | P2p |
| BFR92AW | SOT323 | P2 |
| BFR93 | SOT23 | R1p |
| BFR93A | SOT23 | R2p |
| BFR93AW | SOT323 | R2 |
| BFR94A | SOT122E | BFR94A |
| BFR106 | SOT23 | R7p |
| BFR505 | SOT23 | N30 |
| BFR520 | SOT23 | N28 |
| BFR540 | SOT23 | N29 |
| BFS17 | SOT23 | E1p |
| BFS17A | SOT23 | E2p |
| BFS17W | SOT323 | E1 |
| BFS25A | SOT323 | N6 |
| BFS505 | SOT323 | N0 |
| BFS520 | SOT323 | N2 |
| BFS540 | SOT323 | N4 |
| BFT25 | SOT23 | V1p |
| BFT25A | SOT23 | V10 |
| BFT92 | SOT23 | W1p |
| BFT92W | SOT323 | W1 |
| BFT93 | SOT23 | X1p |
| BFT93W | SOT323 | X1 |
| MPSH10 | SOT54 | PSH10 |
| PMBT3640 | SOT23 | V25 |
| PMBTH10 | SOT23 | V30 |
| PMBTH81 | SOT23 | V31 |

MARKING CODE AND PACKAGE TO TYPE NUMBER

| MARKING CODE | PACKAGE | TYPE NUMBER |
|--------------|---------|-------------|
| BFG16A | SOT223 | BFG16A |
| BFG31 | SOT223 | BFG31 |
| BFG35 | SOT223 | BFG35 |
| BFG94 | SOT223 | BFG94 |
| BFG97 | SOT223 | BFG97 |
| BFG135 | SOT223 | BFG135 |
| BFG198 | SOT223 | BFG198 |
| BFG541 | SOT223 | BFG541 |
| BFG591 | SOT223 | BFG591 |
| BFQ34/01 | SOT122E | BFQ34 |
| BFQ68 | SOT122E | BFQ68 |
| BFQ135 | SOT172 | BFQ135 |
| BFQ136 | SOT122E | BFQ136 |
| BFQ270 | SOT172 | BFQ270 |
| BFQ621 | SOT172 | BFQ621 |
| BFR94A | SOT122E | BFR94A |
| E1 | SOT323 | BFS17W |
| E1p | SOT23 | BFS17 |
| E2 | SOT323 | BF547W |
| E2p | SOT23 | BFS17A |
| E6p | SOT143 | BFG17A |
| E15 | SOT23 | BF747 |
| E16 | SOT23 | BF547 |
| F689K | SOT54 | BF689K |
| F763 | SOT54 | BF763 |
| FA | SOT89 | BFQ17 |
| FB | SOT89 | BFQ19 |
| FF | SOT89 | BFQ18A |
| FG | SOT89 | BFQ149 |
| N0 | SOT323 | BFS505 |
| N0 | SOT343 | BFG505W |
| N0 | SOT353 | BFC505 |
| N0 | SOT363 | BFM505 |
| N1 | SOT343 | BFG505W/X |
| N1p | SOT23 | BFR53 |
| N2 | SOT323 | BFS520 |
| N2 | SOT363 | BFM520 |
| N3 | SOT343 | BFG520W |
| N3 | SOT353 | BFC520 |
| N4 | SOT323 | BFS540 |

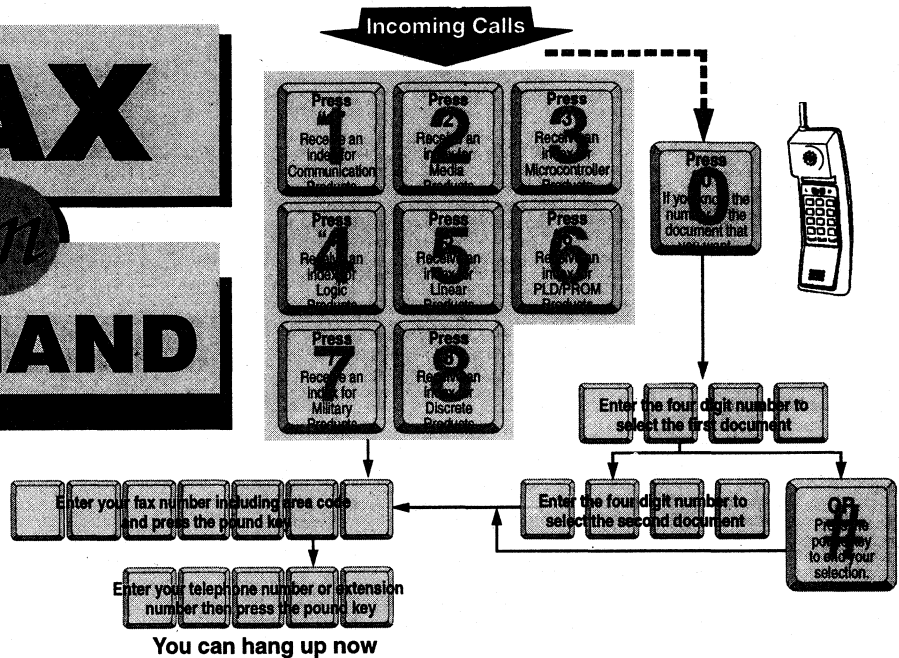
RF Wideband Transistors

Marking codes

| MARKING CODE | PACKAGE | TYPE NUMBER |
|--------------|---------|-------------|
| N4 | SOT343 | BFG520W/X |
| N4 | SOT89 | BFQ540 |
| N5 | SOT343 | BFG520W/XR |
| N5 | SOT353 | BFE520 |
| N6 | SOT323 | BFS25A |
| N6 | SOT343 | BFG25AW |
| N7 | SOT343 | BFG540W/X |
| N8 | SOT343 | BFG540W/XR |
| N9 | SOT343 | BFG540W |
| N28 | SOT23 | BFR520 |
| N29 | SOT23 | BFR540 |
| N30 | SOT23 | BFR505 |
| N33 | SOT143 | BFG505 |
| N36 | SOT143 | BFG520 |
| N37 | SOT143 | BFG540 |
| N38 | SOT143 | BFG590 |
| N39 | SOT143 | BFG505/X |
| N42 | SOT143 | BFG520/X |
| N43 | SOT143 | BFG540/X |
| N44 | SOT143 | BFG590/X |
| N45 | SOT143 | BFG505/XR |
| N48 | SOT143 | BFG520/XR |
| N49 | SOT143 | BFG540/XR |
| N50 | SOT143 | BFG590/XR |
| N70 | SOT143 | BFG10 |
| N71 | SOT143 | BFG10/X |
| N72 | SOT143 | BFG11 |
| N73 | SOT143 | BFG11/X |
| P0 | SOT343 | BFG505W/XR |
| P0 | SOT353 | BFE505 |
| P1 | SOT343 | BFG21W |
| P1p | SOT23 | BFR92 |
| P2 | SOT323 | BFR92AW |
| P2p | SOT23 | BFR92A |
| P3 | SOT343 | BFG403W |
| P4 | SOT343 | BFG410W |
| P5 | SOT343 | BFG425W |
| PSH10 | SOT54 | MPSH10 |
| R1p | SOT23 | BFR93 |
| R2 | SOT323 | BFR93AW |
| R2p | SOT23 | BFR93A |

| MARKING CODE | PACKAGE | TYPE NUMBER |
|--------------|---------|-------------|
| R7p | SOT23 | BFR106 |
| R8p | SOT143 | BFG93A |
| S4 | SOT343 | BFG11W/X |
| T1 | SOT343 | BFG590W |
| T2 | SOT343 | BFG590W/X |
| T3 | SOT343 | BFG590W/XR |
| T5 | SOT343 | BFG10W/X |
| V1 | SOT343 | BFG25AW/X |
| V1p | SOT23 | BFT25 |
| V2 | SOT323 | BFQ67W |
| V2p | SOT23 | BFQ67 |
| V3 | SOT343 | BFG25AW/XR |
| V3p | SOT143 | BFG67 |
| V5p | SOT143 | BFG197 |
| V10 | SOT23 | BFT25A |
| V11 | SOT143 | BFG25A/X |
| V12 | SOT143 | BFG67/X |
| V13 | SOT143 | BFG197/X |
| V14 | SOT143 | BFG92A/X |
| V25 | SOT23 | PMBT3640 |
| V26 | SOT143 | BFG67/XR |
| V29 | SOT143 | BFG92A/XR |
| V30 | SOT23 | PMBTH10 |
| V31 | SOT23 | PMBTH81 |
| V33 | SOT143 | BFG93A/XR |
| W1 | SOT323 | BFT92W |
| W1p | SOT23 | BFT92 |
| X1 | SOT323 | BFT93W |
| X1p | SOT23 | BFT93 |

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QUALITY**Total Quality Management**

Philips Semiconductors is a Quality Company, renowned for the high quality of our products and service. We keep alive this tradition by constantly aiming towards one ultimate standard, that of zero defects. This aim is guided by our Total Quality Management (TQM) system, the basis of which is described in the following paragraphs.

QUALITY ASSURANCE

Based on ISO 9000 standards, customer standards such as Ford TQE and IBM MDQ. Our factories are certified to ISO 9000 by external inspectorates.

PARTNERSHIPS WITH CUSTOMERS

PPM co-operations, design-in agreements, ship-to-stock, just-in-time and self-qualification programmes, and application support.

PARTNERSHIPS WITH SUPPLIERS

Ship-to-stock, statistical process control and ISO 9000 audits.

QUALITY IMPROVEMENT PROGRAMME

Continuous process and system improvement, design improvement, complete use of statistical process control, realization of our final objective of zero defects, and logistics improvement by ship-to-stock and just-in-time agreements.

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During the design and development of new products and processes, quality is built-in by advanced quality planning. Through failure-mode-and-effect analysis the critical parameters are detected and measures taken to ensure good performance on these parameters. The capability of process steps is also planned in this phase.

Product conformance

The assurance of product conformance is an integral part of our quality assurance (QA) practice. This is achieved by:

- Incoming material management through partnerships with suppliers.
- In-line quality assurance to monitor process reproducibility during manufacture and initiate any necessary corrective action. Critical process steps are 100% under statistical process control.

- Acceptance tests on finished products to verify conformance with the device specification. The test results are used for quality feedback and corrective actions. The inspection and test requirements are detailed in the general quality specifications.
- Periodic inspections to monitor and measure the conformance of products.

Product reliability

With the increasing complexity of Original Equipment Manufacturer (OEM) equipment, component reliability must be extremely high. Our research laboratories and development departments study the failure mechanisms of semiconductors. Their studies result in design rules and process optimization for the highest built-in product reliability. Highly accelerated tests are applied to the products reliability evaluation. Rejects from reliability tests and from customer complaints are submitted to failure analysis, to result in corrective action.

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Our quality improvement depends on joint action with our customer. We need our customer's inputs and we invite constructive comments on all aspects of our performance. Please contact our local sales representative.

Recognition

The high quality of our products and services is demonstrated by many Quality Awards granted by major customers and international organizations.

PRO ELECTRON TYPE NUMBERING SYSTEM**Basic type number**

This type designation code applies to discrete semiconductor devices (not integrated circuits), multiples of such devices, semiconductor chips and Darlington transistors.

FIRST LETTER

The first letter gives information about the material for the active part of the device.

- | | |
|---|---|
| A | Germanium or other material with a band gap of 0.6 to 1 eV |
| B | Silicon or other material with a band gap of 1 to 1.3 eV |
| C | Gallium arsenide (GaAs) or other material with a band gap of 1.3 eV or more |
| R | Compound materials, e.g. cadmium sulphide. |

SECOND LETTER

The second letter indicates the function for which the device is primarily designed. The same letter can be used for multi-chip devices with similar elements.

In the following list low power types are defined by $R_{th\ j-mb} > 15\ K/W$ and power types by $R_{th\ j-mb} \leq 15\ K/W$.

| | |
|---|---|
| A | Diode; signal, low power |
| B | Diode; variable capacitance |
| C | Transistor; low power, audio frequency |
| D | Transistor; power, audio frequency |
| E | Diode; tunnel |
| F | Transistor; low power, high frequency |
| G | Multiple of dissimilar devices/miscellaneous devices; e.g. oscillators. Also with special third letter; see under Section "Serial number" |
| H | Diode; magnetic sensitive |
| L | Transistor; power, high frequency |
| N | Photocoupler |
| P | Radiation detector; e.g. high sensitivity photo-transistor; with special third letter |
| Q | Radiation generator; e.g. LED, laser; with special third letter |
| R | Control or switching device; e.g. thyristor, low power; with special third letter |
| S | Transistor; low power, switching |
| T | Control or switching device; e.g. thyristor, low power; with special third letter |
| U | Transistor; power, switching |
| W | Surface acoustic wave device |
| X | Diode; multiplier, e.g. varactor, step recovery |
| Y | Diode; rectifying, booster |
| Z | Diode; voltage reference or regulator, transient suppressor diode; with special third letter. |

SERIAL NUMBER

The number comprises three figures running from 100 to 999 for devices primarily intended for consumer equipment, or one letter (Z, Y, X, etc.) and two figures running from 10 to 99 for devices primarily intended for industrial or professional equipment.⁽¹⁾

(1) When the supply of these serial numbers is exhausted, the serial number may be expanded to three figures for industrial types and four figures for consumer types.

Version letter

A letter may be added to the basic type number to indicate minor electrical or mechanical variants of the basic type.

RATING SYSTEMS

The rating systems described are those recommended by the IEC in its publication number 134.

Definitions of terms used

ELECTRONIC DEVICE

An electronic tube or valve, transistor or other semiconductor device. This definition excludes inductors, capacitors, resistors and similar components.

CHARACTERISTIC

A characteristic is an inherent and measurable property of a device. Such a property may be electrical, mechanical, thermal, hydraulic, electro-magnetic or nuclear, and can be expressed as a value for stated or recognized conditions. A characteristic may also be a set of related values, usually shown in graphical form.

BOGEY ELECTRONIC DEVICE

An electronic device whose characteristics have the published nominal values for the type. A bogey electronic device for any particular application can be obtained by considering only those characteristics that are directly related to the application.

RATING

A value that establishes either a limiting capability or a limiting condition for an electronic device. It is determined for specified values of environment and operation, and may be stated in any suitable terms. Limiting conditions may be either maxima or minima.

RATING SYSTEM

The set of principles upon which ratings are established and which determine their interpretation. The rating system indicates the division of responsibility between the device manufacturer and the circuit designer, with the object of ensuring that the working conditions do not exceed the ratings.

Absolute maximum rating system

Absolute maximum ratings are limiting values of operating and environmental conditions applicable to any electronic

device of a specified type, as defined by its published data, which should not be exceeded under the worst probable conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device, taking no responsibility for equipment variations, environmental variations, and the effects of changes in operating conditions due to variations in the characteristics of the device under consideration and of all other electronic devices in the equipment.

The equipment manufacturer should design so that, initially and throughout the life of the device, no absolute maximum value for the intended service is exceeded with any device, under the worst probable operating conditions with respect to supply voltage variation, equipment component variation, equipment control adjustment, load variations, signal variation, environmental conditions, and variations in characteristics of the device under consideration and of all other electronic devices in the equipment.

Design maximum rating system

Design maximum ratings are limiting values of operating and environmental conditions applicable to a bogey electronic device of a specified type as defined by its published data, and should not be exceeded under the worst probable conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device, taking responsibility for the effects of changes in operating conditions due to variations in the characteristics of the electronic device under consideration.

The equipment manufacturer should design so that, initially and throughout the life of the device, no design maximum value for the intended service is exceeded with a bogey electronic device, under the worst probable operating conditions with respect to supply voltage variation, equipment component variation, variation in characteristics of all other devices in the equipment, equipment control adjustment, load variation, signal variation and environmental conditions.

Design centre rating system

Design centre ratings are limiting values of operating and environmental conditions applicable to a bogey electronic device of a specified type as defined by its published data, and should not be exceeded under normal conditions.

These values are chosen by the device manufacturer to provide acceptable serviceability of the device in average

applications, taking responsibility for normal changes in operating conditions due to rated supply voltage variation, equipment component variation, equipment control adjustment, load variation, signal variation, environmental conditions, and variations in the characteristics of all electronic devices.

The equipment manufacturer should design so that, initially, no design centre value for the intended service is exceeded with a bogey electronic device in equipment operating at the stated normal supply voltage.

LETTER SYMBOLS

The letter symbols for transistors detailed in this section are based on IEC publication number 148.

Basic letters

In the representation of currents, voltages and powers, lower-case letter symbols are used to indicate all instantaneous values that vary with time. All other values are represented by upper-case letters.

Electrical parameters⁽¹⁾ of external circuits and of circuits in which the device forms only a part are represented by upper-case letters. Lower-case letters are used for the representation of electrical parameters inherent in the device. Inductances and capacitances are always represented by upper-case letters.

The following is a list of basic letter symbols used with semiconductor devices:

| | |
|------|---|
| B, b | Susceptance (imaginary part of an admittance) |
| C | Capacitance |
| G, g | Conductance (real part of an admittance) |
| H, h | Hybrid parameter |
| I, i | Current |
| L | Inductance |
| P, p | Power |
| R, r | Resistance (real part of an impedance) |
| V, v | Voltage |
| X, x | Reactance (imaginary part of an impedance) |
| Y, y | Admittance |
| Z, z | Impedance. |

(1) For the purpose of this publication, the term 'electrical parameters' applies to four-pole matrix parameters, elements of electrical equivalent circuits, electrical impedances and admittances, inductances and capacitances.

Subscripts

Upper-case subscripts are used for the indication of:

- Continuous (DC) values (without signal), e.g. I_D , I_B
- Instantaneous total values, e.g. I_D , I_B
- Average total values, e.g. $I_{D(AV)}$, $I_{B(AV)}$
- Peak total values, e.g. I_{DM} , I_{BM}
- Root-mean-square total values, e.g. $I_{D(RMS)}$; $I_{B(RMS)}$.

Lower-case subscripts are used for the indication of values applying to the varying component alone:

- Instantaneous values, e.g. i_b
- Root-mean-square values, e.g. $I_{d(rms)}$
- Peak values, e.g. I_{bm}
- Average values, e.g. $I_{d(av)}$.

The following is a list of subscripts used with basic letter symbols for semiconductor devices:

| | |
|------------|---|
| A, a | anode |
| amb | ambient |
| (AV), (av) | average value |
| B, b | base |
| (BO) | breakover |
| (BR) | breakdown |
| case | case |
| C, c | collector |
| C | controllable |
| D, d | drain |
| E, e | emitter |
| F, f | fall, forward (or forward transfer) |
| G, g | gate |
| H | holding |
| h | heatsink |
| I, i | input |
| j-a | junction to ambient |
| j-mb | junction to mounting base |
| K, k | cathode |
| L | load |
| M, m | peak value |
| (min) | minimum |
| (max) | maximum |
| mb | mounting base |
| O, o | As first subscript: reverse (or reverse transfer), rise. As second subscript: |

| | |
|--------------|---|
| (OV) | Overload |
| P, p | Pulse |
| Q, q | Turn-off |
| R, r | As first subscript: reverse (or reverse transfer), rise. As second subscript: repetitive, recovery. As third subscript: with a specified resistance between the terminal not mentioned and the reference terminal |
| (RMS), (rms) | Root-mean-square value |
| S, s | As first subscript: series, source, storage, stray, switching. As second subscript: surge (non-repetitive). As third subscript: short circuit between the terminal not mentioned and the reference terminal |
| stg | Storage |
| th | Thermal |
| TO | Threshold |
| tot | Total |
| W | Working |
| X, x | Specified circuit |
| Z, z | Reference or regulator (zener) |
| 1 | Input (four-pole matrix) |
| 2 | Output (four-pole matrix). |

Applications and examples

TRANSISTOR CURRENTS

The first subscript indicates the terminal carrying the current (conventional current flow from the external circuit into the terminal is positive).

Examples: I_D , I_B , i_D , i_B , I_{d} , I_{b} , I_{dm} , I_{bm} .

TRANSISTOR VOLTAGES

A voltage is indicated by the first two subscripts: the first identifies the terminal at which the voltage is measured and the second the reference terminal or the circuit node. The second subscript may be omitted when there is no possibility of confusion.

Examples: V_{GS} , V_{GS} , V_{gs} , V_{gsm} , V_{BE} , V_{BE} , V_{be} , V_{bem} .

SUPPLY VOLTAGES OR CURRENTS

Supply voltages or supply currents are indicated by repeating the appropriate terminal subscript.

RF Wideband Transistors

General section

Examples: V_{DD} , I_{SS} , V_{CC} ; I_{EE} .

A reference terminal is indicated by a third subscript.

Example: V_{DDB} , V_{CCE} .

DEVICES WITH MORE THAN ONE TERMINAL OF THE SAME KIND

If a device has more than one terminal of the same kind, the subscript is formed by the appropriate letter for the terminal, followed by a number. Hyphens may be used to avoid confusion in multiple subscripts.

Examples:

I_{D2} Continuous (DC) current flowing into the second gate terminal

V_{B2-E} Continuous (DC) voltage between the terminals of second base and emitter.

MULTIPLE DEVICES

For multiple unit devices, the subscripts are modified by a number preceding the letter subscript. Hyphens may be used to avoid confusion in multiple subscripts.

Examples:

I_{2B} Continuous (DC) current flowing into the base terminal of the second unit

V_{1D-2D} Continuous (DC) voltage between the drain terminals of the first and second units.

ELECTRICAL PARAMETERS

The upper-case variant of a subscript is used for the designation of static (DC) values.

Examples:

g_{FS} Static value of forward transconductance in common-source configuration (DC current gain)

h_{FE} Static value of forward current transfer in common-emitter configuration (DC current gain)

R_{DS} DC value of the drain-source resistance.

R_E DC value of the external emitter resistance.

The static value is the slope of the line from the origin to the operating point on the appropriate characteristic curve, i.e. the quotient of the appropriate electrical quantities at the operating point.

The lower-case variant of a subscript is used for the designation of small-signal values.

Examples:

g_{fs} Small-signal value of the short-circuit forward transconductance in common-source configuration

h_{fe} Small-signal value of the short-circuit forward current transfer ratio in common-emitter configuration

$Z_i = R_i + jX_i$ Small-signal value of the input impedance.

If more than one subscript is used, subscripts for which a choice of style is allowed, the subscripts chosen are all upper-case or all lower-case.

Examples: h_{FE} , Y_{RE} , h_{fe} , g_{FS} .

FOUR-POLE MATRIX PARAMETERS

The first letter subscript (or double numeric subscript) indicates input, output, forward transfer or reverse transfer.

Examples: h_i (or h_{11}), h_o (or h_{22}), h_f (or h_{21}), h_r (or h_{12}).

A further subscript is used for the identification of the circuit configuration. When no confusion is possible, this further subscript may be omitted.

Examples: h_{fe} (or h_{21e}), h_{FE} (or h_{21E}).

DISTINCTION BETWEEN REAL AND IMAGINARY PARTS

If it is necessary to distinguish between real and imaginary parts of electrical parameters, no additional subscripts are used. If basic symbols for the real and imaginary parts exist, these may be used.

Examples: $Z_i = R_i + jX_i$, $Y_{fe} = g_{fe} + jb_{fe}$.

If such symbols do not exist or are not suitable, the notation shown in the following examples is used.

Examples:

$Re(h_{ib})$ etc. for the real part of h_{ib}

$Im(h_{ib})$ etc. for the imaginary part of h_{ib} .

S-PARAMETER DEFINITIONS

The S-parameter symbols in this section are based on IEC publication 747 – 7.

S-parameters (return losses or reflection coefficients) of a module can be defined as the S_{11} and S_{22} of a two-port network (see Fig.1).

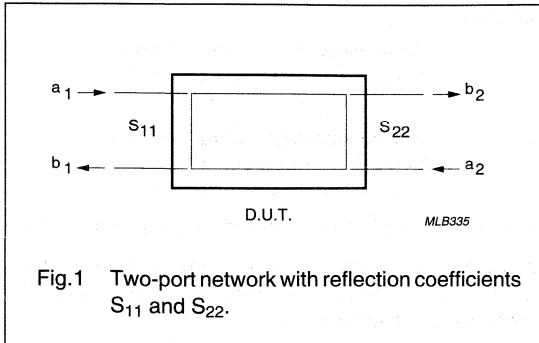


Fig.1 Two-port network with reflection coefficients S_{11} and S_{22} .

$$b_1 = S_{11} \times a_1 + S_{12} \times a_2 \quad (1)$$

$$b_2 = S_{21} \times a_1 + S_{22} \times a_2 \quad (2)$$

where:

$$a_1 = \frac{1}{2 \times \sqrt{Z_0}} \times (V_1 + Z_0 \times i_1) = \text{signal into port 1} \quad (3)$$

$$a_2 = \frac{1}{2 \times \sqrt{Z_0}} \times (V_2 + Z_0 \times i_2) = \text{signal into port 2}$$

$$b_1 = \frac{1}{2 \times \sqrt{Z_0}} \times (V_1 - Z_0 \times i_1) = \text{signal out port 1} \quad (4)$$

$$b_2 = \frac{1}{2 \times \sqrt{Z_0}} \times (V_2 - Z_0 \times i_2) = \text{signal out port 2}$$

From (1) and (2) formulae for the return losses can be derived:

$$S_{11} = \left. \frac{b_1}{a_1} \right|_{a_2 = 0} \quad (5)$$

$$S_{22} = \left. \frac{b_2}{a_2} \right|_{a_1 = 0} \quad (6)$$

In (5), $a_2 = 0$ means output port terminated with Z_0 (derived from formula (4)).

In (6), $a_1 = 0$ means input port terminated with Z_0 (derived from formula (3)).

Measurement

The return losses are measured with a network analyzer after calibration, where the influence of the test jig is eliminated. The necessary termination of the other port with Z_0 is done automatically by the network analyzer.

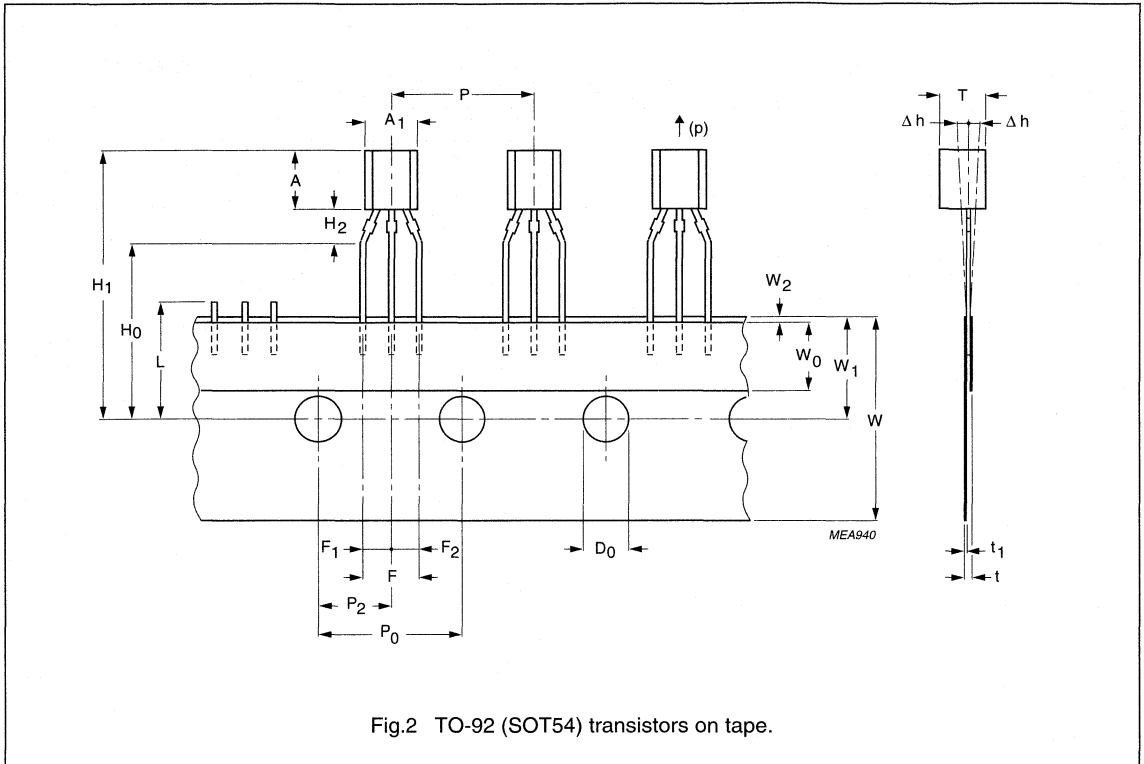
The network analyser must have a directivity of at least 40 dB to obtain an accuracy of 0.5 dB when measuring return loss figures of 20 dB. A full two-port correction method can be used to improve the accuracy.

TAPE AND REEL PACKING

Tape and reel packing meets the feed requirements of automatic pick and place equipment (packing conforms to IEC publication 286-2 and 286-3). Additionally, the tape is an ideal shipping container.

Packing TO-92 (SOT54) leaded types

The transistors are supplied on tape in boxes (ammopack) or on reels. The number per reel and per ammopack is 2000. The ammopack has 80 layers of 25 transistors each. Each layer contains 25 transistors, plus one empty position in order to fold the layer correctly. The ammopack is accessible from both sides, enabling the user to choose between 'normal' (see Fig.3) and 'reverse' tape. 'Normal' is indicated by a plus sign (+) on the ammopack and 'reverse' by a minus sign (-). In the European version, the leading pin is the emitter.



RF Wideband Transistors

General section

Table 1 Tape specification TO-92 (SOT54) leaded types

| SYMBOL | DIMENSION | SPECIFICATIONS | | | | | REMARKS |
|---------------------------------|--------------------------------------|----------------|------|-------|-----------|------|------------------------------------|
| | | MIN. | NOM. | MAX. | TOL. | UNIT | |
| A ₁ | body width | 4 | – | 4.8 | – | mm | |
| A | body height | 4.8 | – | 5.2 | – | mm | |
| T | body thickness | 3.5 | – | 3.9 | – | mm | |
| P | pitch of component | – | 12.7 | – | ±1 | mm | |
| P ₀ | feed hole pitch | – | 12.7 | – | ±0.3 | mm | |
| | cumulative pitch error | – | – | – | ±0.1 | | note 1 |
| P ₂ | feed hole centre to component centre | – | 6.35 | – | ±0.4 | mm | to be measured at bottom of clinch |
| F | distance between outer leads | – | 5.08 | – | +0.6/–0.2 | mm | |
| Δh | component alignment | – | 0 | 1 | – | mm | at top of body |
| W | tape width | – | 18 | – | ±0.5 | mm | |
| W ₀ | hold-down tape width | – | 6 | – | ±0.2 | mm | |
| W ₁ | hole position | – | 9 | – | +0.7/–0.5 | mm | |
| W ₂ | hold-down tape position | – | 0.5 | – | ±0.2 | mm | |
| H ₀ | lead wire clinch height | – | 16.5 | – | ±0.5 | mm | |
| H ₁ | component height | – | – | 23.25 | – | mm | |
| L | length of snapped leads | – | – | 11 | – | mm | |
| D ₀ | feed hole diameter | – | 4 | – | ±0.2 | mm | |
| t | total tape thickness | – | – | 1.2 | – | mm | t ₁ = 0.3 to 0.6 |
| F ₁ , F ₂ | lead-to-lead distance | – | – | – | +0.4/–0.2 | mm | |
| H ₂ | clinch height | – | – | – | – | mm | |
| (p) | pull-out force | 6 | – | – | – | N | |

Note

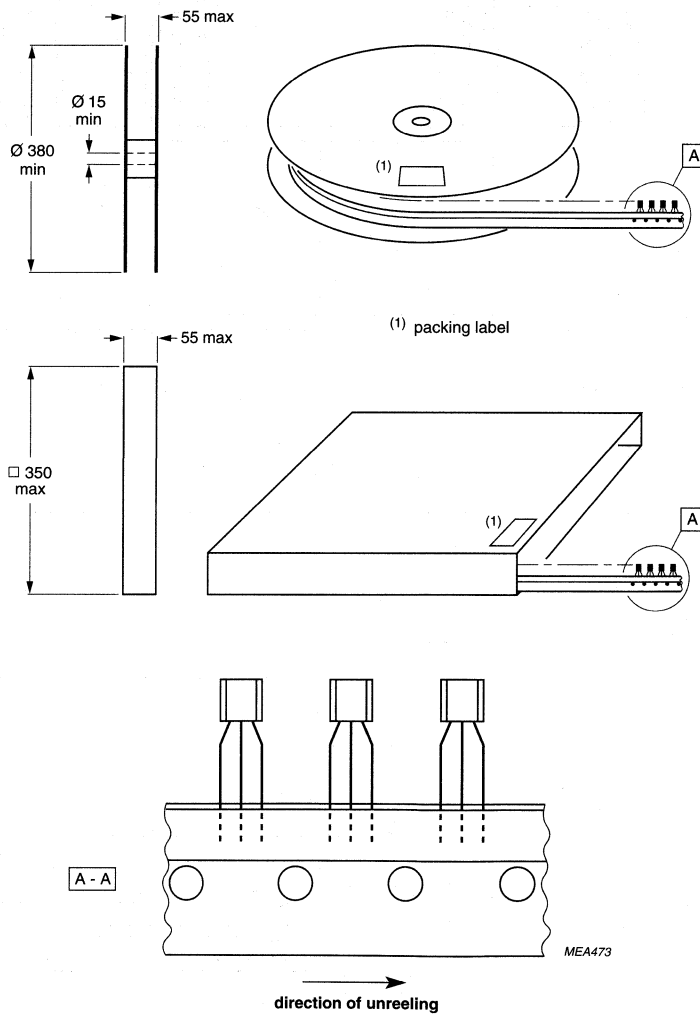
1. Measured over 20 devices.

Dropouts

A maximum of 0.5% of the specified number of transistors in each packing may be missing. Up to 3 consecutive components may be missing provided the gap is followed by 6 consecutive components.

Tape splicing

Splice the carrier tape on the back and/or front so that the feed hole pitch (P₀) is maintained (see Figs 2 and 4).



Dimensions in mm.

Fig.3 Dimensions of reel and box.

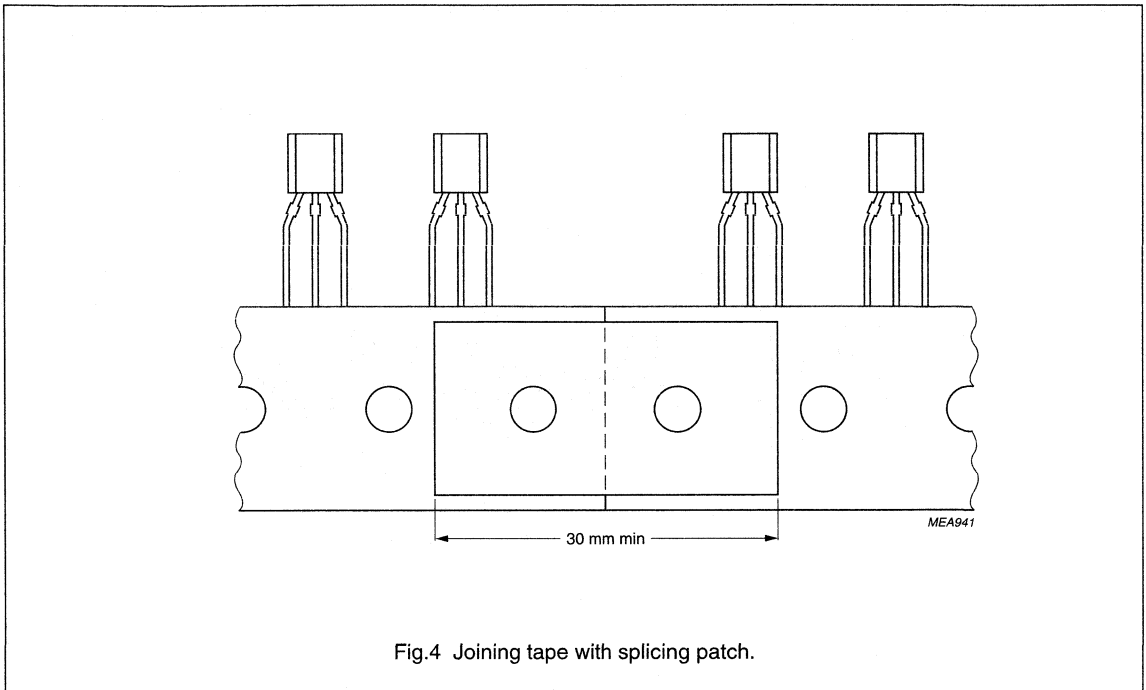
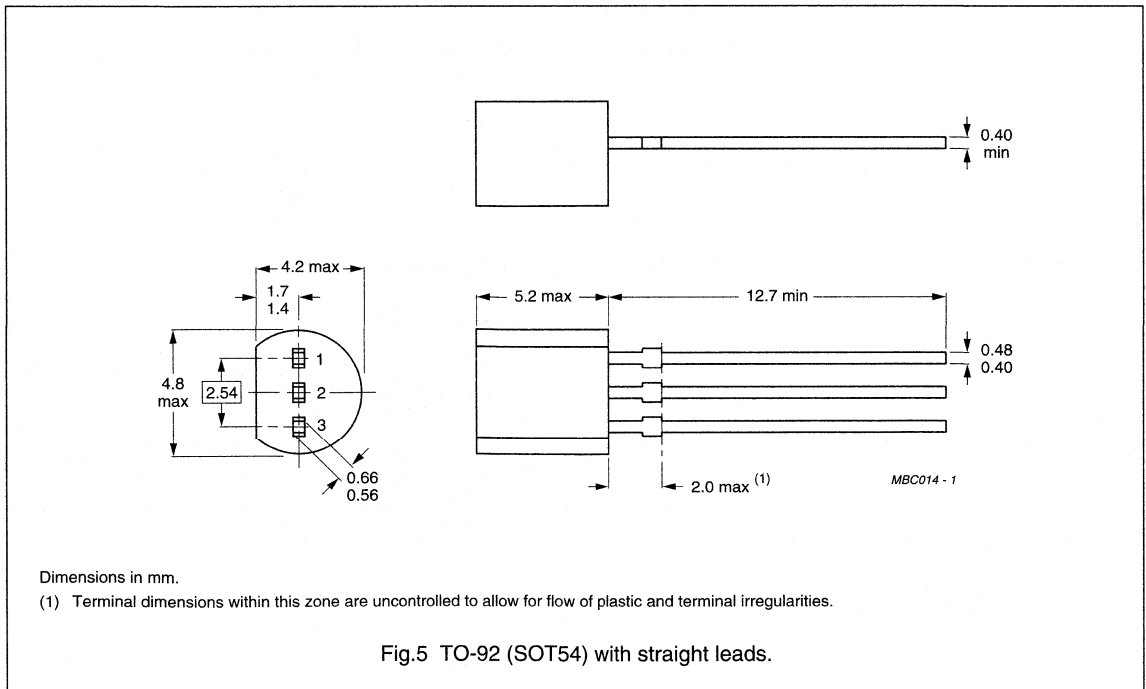


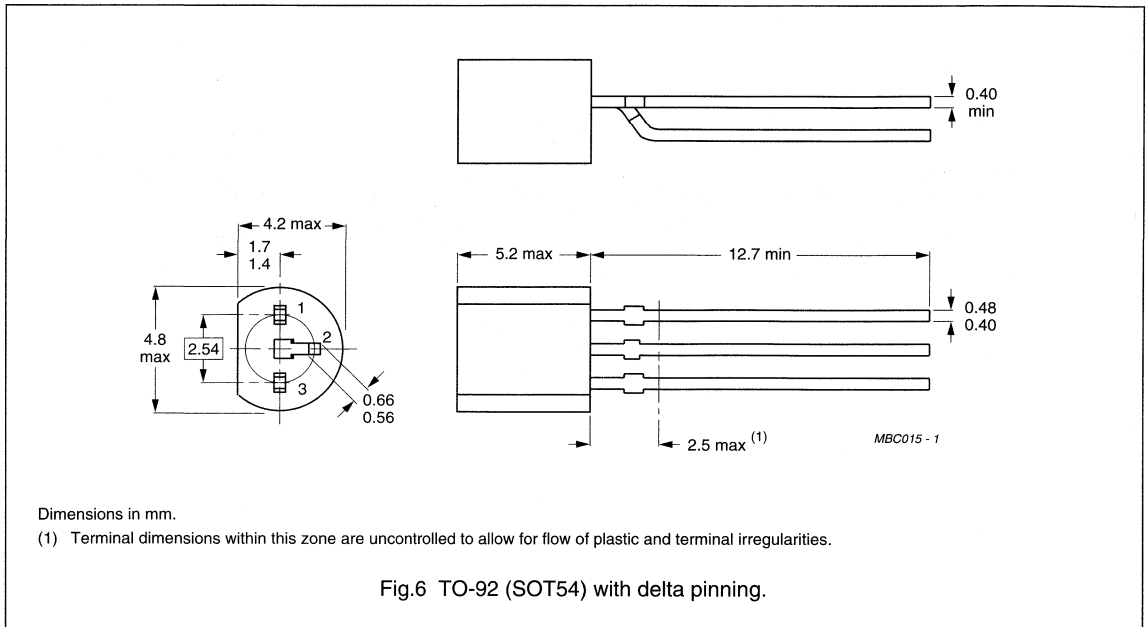
Fig.4 Joining tape with splicing patch.



Dimensions in mm.

(1) Terminal dimensions within this zone are uncontrolled to allow for flow of plastic and terminal irregularities.

Fig.5 TO-92 (SOT54) with straight leads.



Packing types

Table 2 Packing quantities per reel

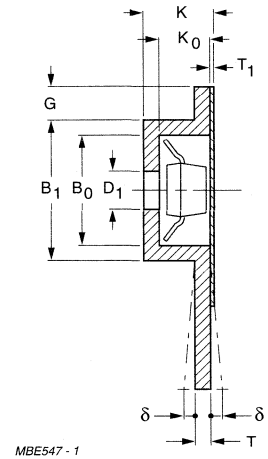
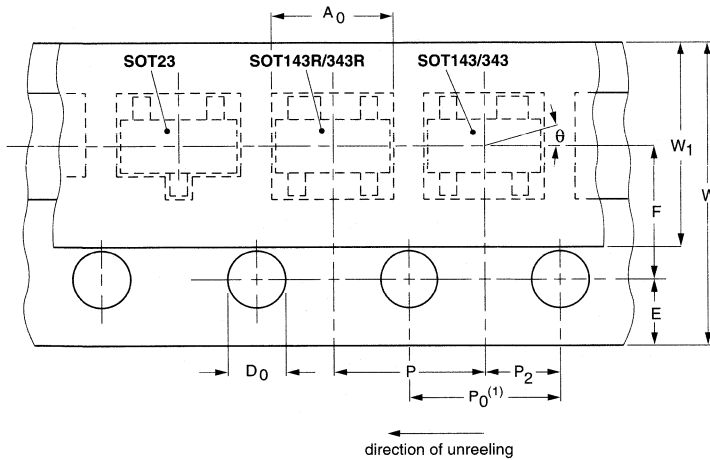
| PACKAGE | TAPE WIDTH (mm) | REEL SIZE (mm) | QUANTITY PER REEL | 12NC (note 1) ends with: |
|---------------------------------|--------------------|-------------------|----------------------|--------------------------------|
| SOT23 | 8 | 180 | 3000 | ...215 |
| | | 330 | 10000 | ...235 |
| SOT143 | 8 | 180 | 3000 | ...215 |
| SOT143R | | 330 | 10000 | ...235 |
| SOT143 (cross emitter pinning) | | 180 | 3000 | ...215 |
| SOT143R (cross emitter pinning) | | 330 | 10000 | ...235 |
| SOT323 | 8 | 180 | 3000 | ...115 |
| | | 330 | 10000 | ...135 |
| SOT343 | 8 | 180 | 3000 | ...115 |
| SOT353 | 8 | 180 | 3000 | ...115 |
| SOT363 | 8 | 180 | 3000 | ...115 |
| SOT89 | 12 | 180 | 3000 | ...115 |
| SOT223 | 12 | 180 | 3000 | ...115 |

Notes

- 12NC is the Philips twelve-digit ordering code.

RF Wideband Transistors

General section

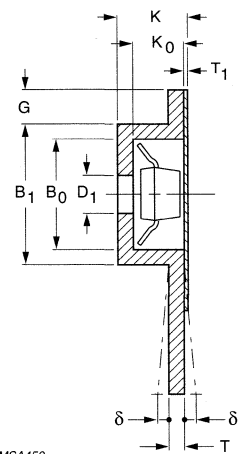
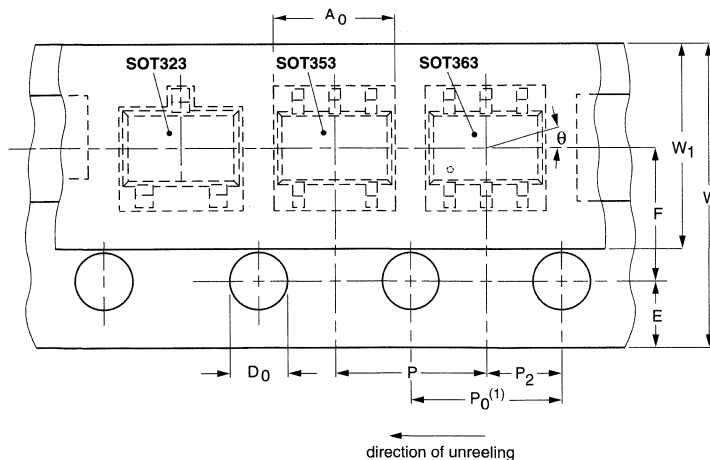


MBE547 - 1

For dimensions see Table 3.

(1) Tolerance over any 10 pitches: ± 0.2 mm.

Fig.7 Specification for 8 mm tape (SOT23, SOT143, SOT143R, SOT343 and SOT343R).

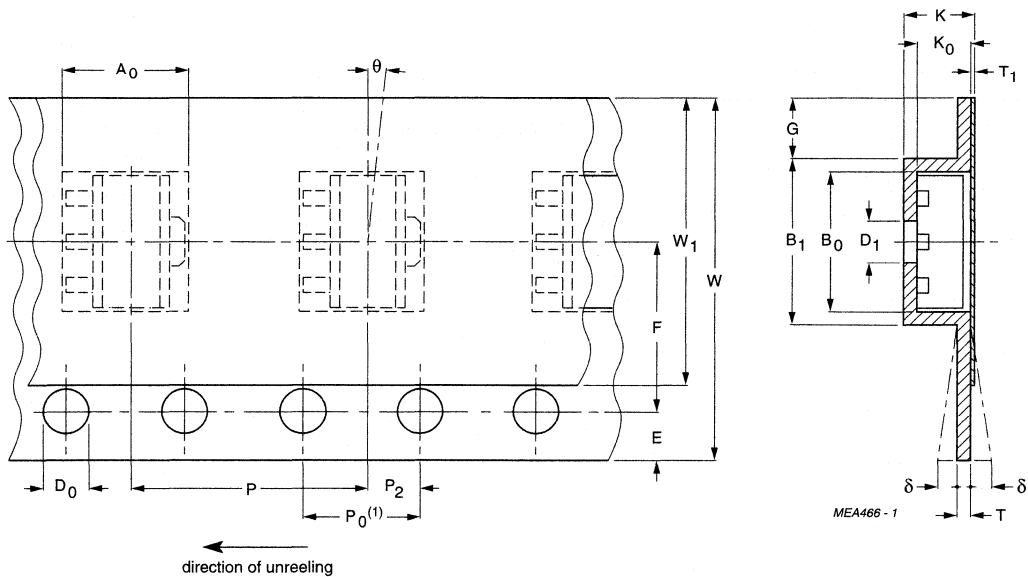


MSA450

For dimensions see Table 3.

(1) Tolerance over any 10 pitches: ± 0.2 mm.

Fig.8 Specification for 8 mm tape (SOT323, SOT353 and SOT363).



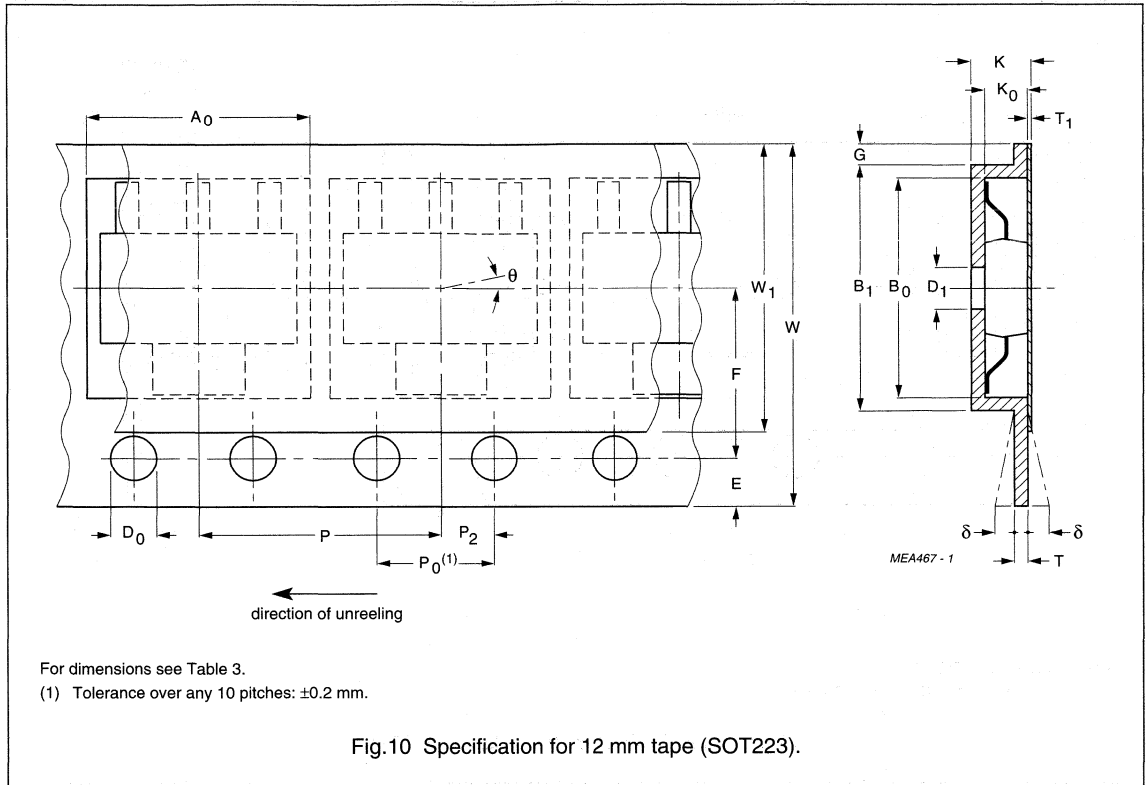
For dimensions see Table 3.

(1) Tolerance over any 10 pitches: ± 0.2 mm.

Fig.9 Specification for 12 mm tape (SOT89).

RF Wideband Transistors

General section



RF Wideband Transistors

General section

Table 3 SMD packages: tape dimensions (in mm)

| DIMENSION (Figs 7 to 12) | CARRIER TAPE | | | TOLERANCE |
|---------------------------------------|--|-------|-------|-----------|
| | 8 mm | 12 mm | 16 mm | |
| Overall dimensions | | | | |
| W | 8.0 | 12.0 | 16.0 | ±0.2 |
| K | <1.5 | <2.4 | <2.2 | – |
| G | >0.75 | >0.75 | >1.65 | – |
| Sprocket holes; note 1 | | | | |
| D ₀ | 1.5 | 1.5 | 1.5 | +0.1/–0 |
| E | 1.75 | 1.75 | 1.75 | ±0.1 |
| P ₀ | 4.0 | 4.0 | 4.0 | ±0.1 |
| Relative placement compartment | | | | |
| P ₂ | 2.0 | 2.0 | 2.0 | ±0.1 |
| F | 3.5 | 5.5 | 7.5 | ±0.05 |
| Compartment | | | | |
| A ₀ | Compartment dimensions depend on package size. Maximum clearance between device and compartment is 0.3 mm; the minimum clearance ensures that the device is not totally restrained within the compartment. | | | |
| B ₀ | | | | |
| B ₁ | | | | |
| K ₀ | | | | |
| D ₁ | >1.0 | >1.5 | >1.5 | – |
| P | 4.0 | 8.0 | 12.0 | ±0.1 |
| θ | <15° | <15° | – | – |
| Cover tape; note 2 | | | | |
| W ₁ | <5.4 | <9.5 | – | – |
| T ₁ | <0.1 | <0.1 | – | – |
| Carrier tape | | | | |
| W | 8.0 | 12.0 | 16.0 | ±0.2 |
| T | <0.2 | <0.2 | <0.4 | – |
| δ | <0.3 | <0.3 | <0.3 | – |

Notes

1. Tolerance over any 10 pitches ±0.2 mm.
2. The cover tape shall not overlap the tape or sprocket holes.

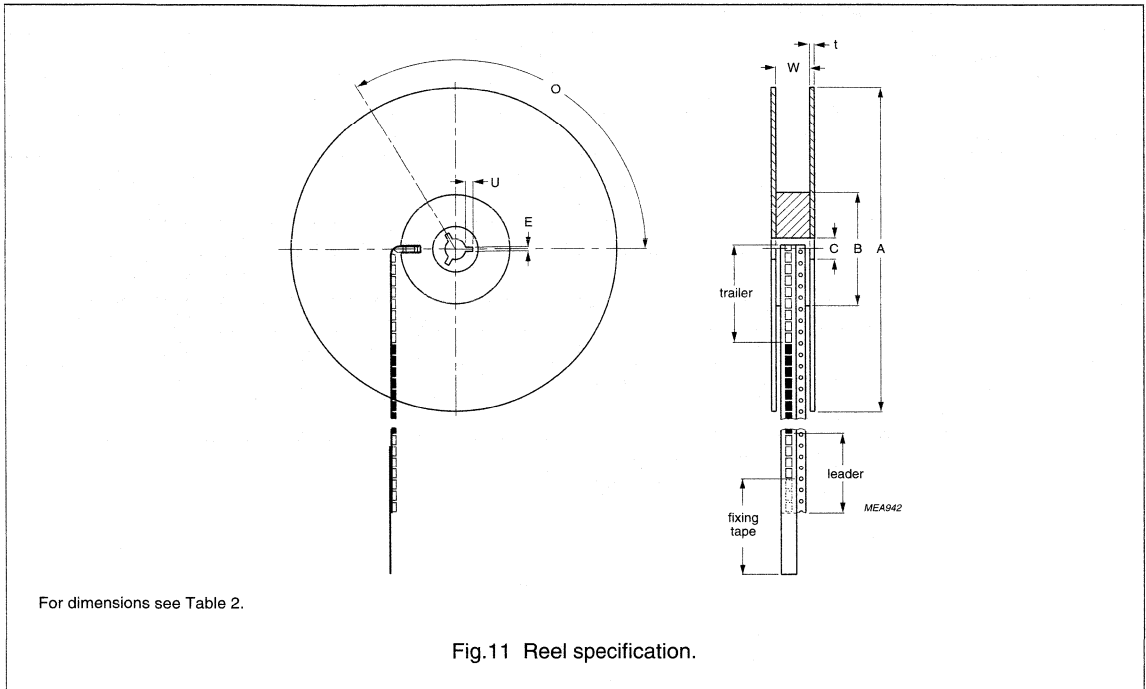
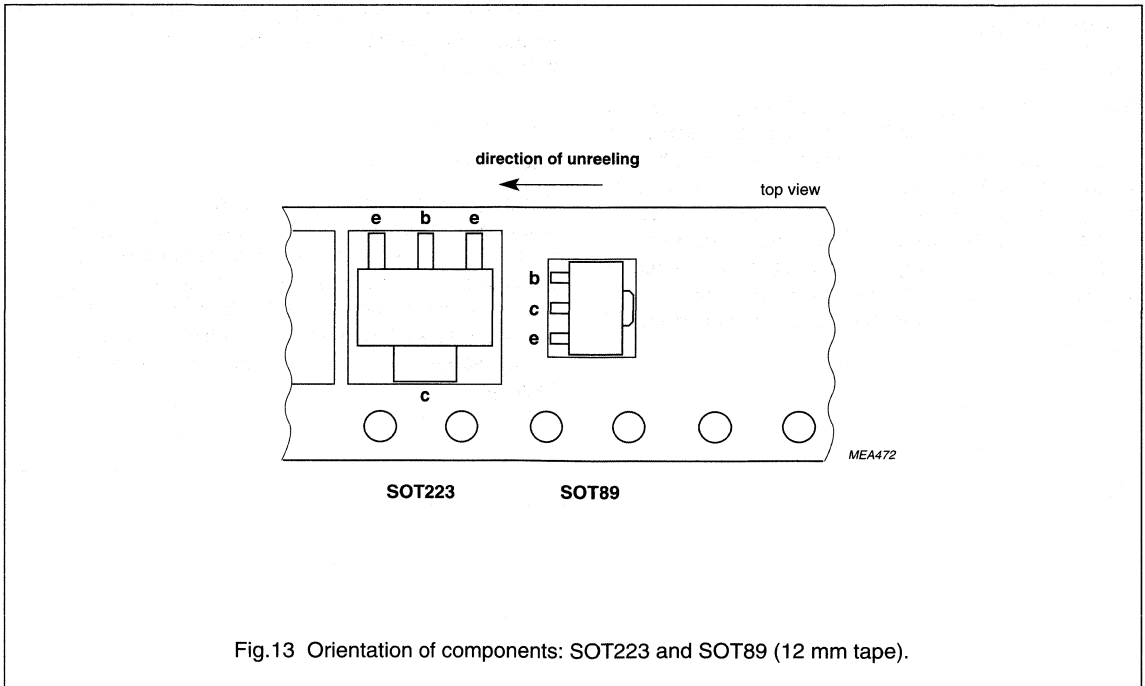
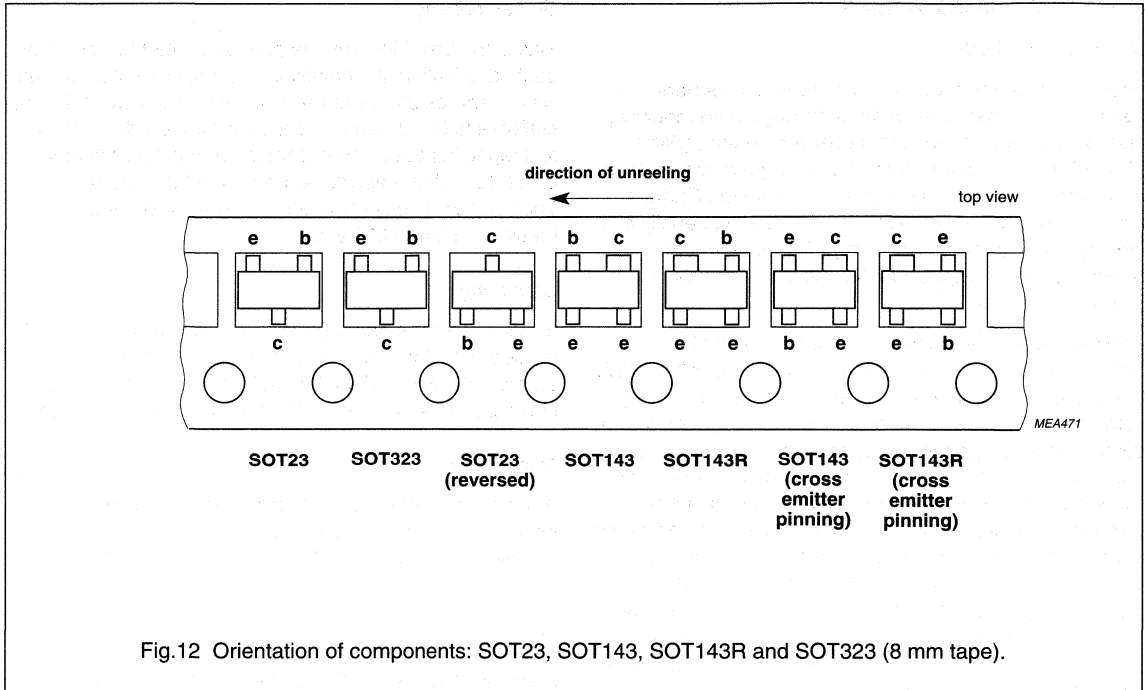


Table 4 Reel dimensions (in mm)

| DIMENSION (see Fig.11) | CARRIER TAPE | | | TOLERANCE |
|---------------------------|---------------------------------|------------|------------|------------|
| | 8 mm | 12 mm | 16 mm | |
| Flange | | | | |
| A | 180 ⁽¹⁾ – 286 or 330 | 180 or 330 | 180 or 330 | ±0.5 |
| t | 1.5 | 1.5 | 1.5 | +0.5/-0.1 |
| W | 8.4 | 12.4 | 18 | 18.0+0.2 |
| Hub | | | | |
| B | 62 | 62 | 62 | ±1.5 |
| C | 12.75 | 12.75 | 12.75 | +0.15/-0.2 |
| Key slot | | | | |
| E | 2 | 2 | 2 | ±0.2 |
| U | 4 | 4 | 4 | ±0.5 |
| O | 120° | 120° | 120° | – |

Note

1. Large reel diameter depends on individual package (286 or 350).



MOUNTING AND SOLDERING

Mounting methods

There are two basic forms of electronic component construction, those with leads for through-hole mounting and microminiature types for surface mounting (SMD). Through-hole mounting gives a very rugged construction and uses well established soldering methods. Surface mounting has the advantages of high packing density plus high-speed automated assembly. Surface mounting techniques are complex and this chapter gives only a simplified overview of the subject.

Although many electronic components are available as surface mounting types, some are not and this often leads to the use of through-hole as well as surface mounting components on one substrate (a mixed print). The mix of components affects the soldering methods that can be applied. A substrate having SMDs mounted on one or both sides but no through-hole components is likely to be suitable for reflow or wave soldering. A double sided mixed print that has through-hole components and some SMDs on one side and densely packed SMDs on the other normally undergoes a sequential combination of reflow and wave soldering. When the mixed print has only through-hole components on one side and all SMDs on the other, wave soldering is usually applied.

Reflow soldering

SOLDER PASTE

Most reflow soldering techniques utilize a paste that is a mixture of flux and solder. The solder paste is applied to the substrate before the components are placed. It is of sufficient viscosity to hold the components in place and, therefore, an application of adhesive is not required. Drying of the solder paste by preheating increases the viscosity and prevents any tendency for the components to become displaced during the soldering process. Preheating also minimizes thermal shock and drives off flux solvents.

Screen printing

This is the best high-volume production method of solder paste application. An emulsion-coated, fine mesh screen with apertures etched in the emulsion to coincide with the surfaces to be soldered is placed over the substrate. A squeegee is passed across the screen to force solder paste through the apertures and on to the substrate. The layer thickness of screened solder paste is usually between 150 and 200 μm .

Stencilling

In this method a stencil with etched holes to pass the paste is used. The thickness of the stencil determines the amount of amount of solder paste that is deposited on the substrate. This method is also suited to high-volume work.

Dispensing

A computer-controlled pressure syringe dispenses small doses of paste to where it is required. This method is mainly suitable for small production runs and laboratory use.

Pin transfer

A pin picks up a droplet of solder paste from a reservoir and transfers it to the surface of the substrate or component. A multi-pin arrangement with pins positioned to match the substrate is possible and this speeds up the process time.

REFLOW TECHNIQUES

Thermal conduction

The prepared substrates are carried on a conveyor belt, first through a preheating stage and then through a soldering stage. Heat is transferred to the substrate by conduction through the belt. Figure 14 shows a theoretical time/temperature relationship for thermal conduction reflow soldering. This method is particularly suited to thick film substrates and is often combined with infrared heating.

Infrared

An infrared oven has several heating elements giving a broad spectrum of infrared radiation, normally above and below a closed loop belt system. There are separate zones for preheating, soldering and cooling. Dwell time in the soldering zone is kept as short as possible to prevent damage to components and substrate. A typical heating profile is shown in Fig.15. This reflow method is often applied in double-sided prints.

Vapour phase

A substrate is immersed in the vapours of a suitable boiling liquid. The vapours transfer latent heat of condensation to the substrate and solder reflow takes place. Temperature is controlled precisely by the boiling point of the liquid at a given pressure. Some systems employ two vapour zones, one above the other. An elevator tray, suspended from a hoist mechanism passes the substrate vertically through the first vapour zone into the secondary soldering zone and then hoists it out of the vapour to be cooled. A theoretical time/temperature relationship for this method is shown in Fig.16.

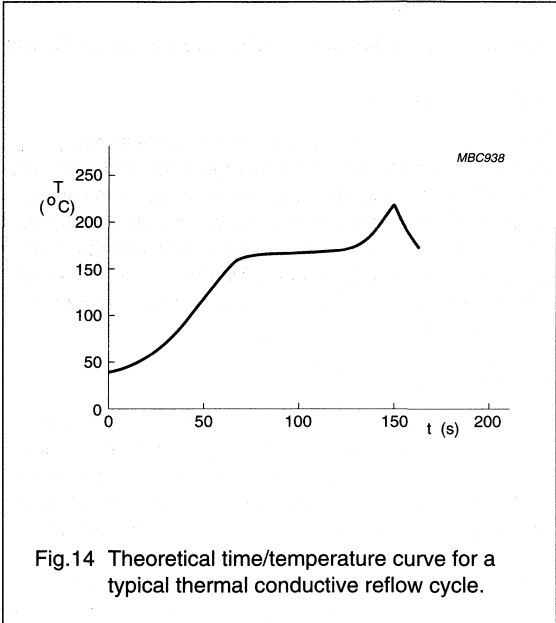


Fig.14 Theoretical time/temperature curve for a typical thermal conductive reflow cycle.

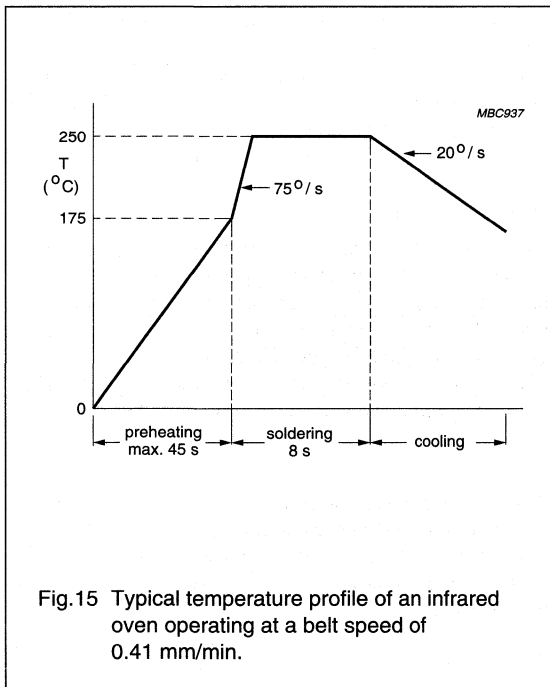


Fig.15 Typical temperature profile of an infrared oven operating at a belt speed of 0.41 mm/min.

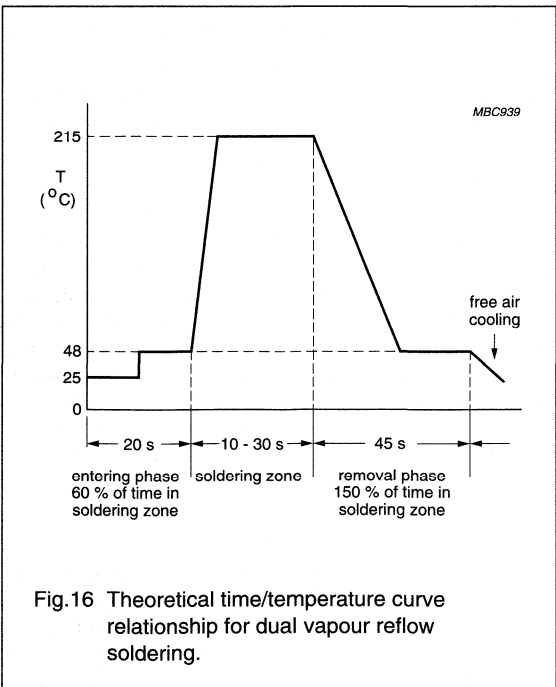


Fig.16 Theoretical time/temperature curve relationship for dual vapour reflow soldering.

Wave soldering

This soldering technique is not recommended for SOT89.

ADHESIVE APPLICATION

Since there are no connecting wires to retain them, leadless and short-leaded components are held in place with adhesive for wave soldering. A spot of adhesive is carefully placed between each SMD and the substrate. The adhesive is then heat-cured to withstand the forces of the soldering process, during which the components are fully immersed in solder. There are several methods of adhesive application.

Pin transfer method

A pin is used to transfer a droplet of adhesive from a reservoir to a precise position on the surface where it is required. The size of the droplet depends on pin diameter, depth to which the pin is dipped in the reservoir, rheology of the adhesive, and the temperature of adhesive and surrounds. The pin can be part of a pin array (bed of nails) that corresponds exactly with the required adhesive positions on the substrate. With this method, adhesive can be applied to the whole of one side of a substrate in one operation and is therefore suitable for high-volume production and can be used with pre-loaded mixed prints.

Alternatively, pins can be used to transfer adhesive to the components before they are placed on the substrate. This adds flexibility to production runs where variations in layout must be accommodated.

Screen printing method

A fine mesh screen is coated with emulsion except in the positions where the adhesive is required to pass. The screen is placed on the substrate and a squeegee passing across it forces adhesive through the uncoated parts of the screen. The amount of adhesive printed-through depends on the size of the uncoated screen areas, the thickness of the screen coating, the rheology of the adhesive and various machine parameters. With this method, the substrate must be flat and pre-loaded mixed prints cannot be accommodated.

Pressure syringe method

A computer-controlled syringe dispenses adhesive from an enclosed reservoir by means of pulses of compressed air. The adhesive dot size depends on the size of the syringe nozzle, the duration and pressure of the pulsed air and the viscosity of the adhesive. This method is most

suited to low volume production. An advantage is the flexibility provided by computer programmability.

FLUXING

The quality of the soldered connections between components and substrate is critical for circuit performance and reliability. Flux promotes solderability of the connecting surfaces and is chosen for the following attributes:

- Removal of surface oxides
- Prevention of reoxidation
- Transference of heat from source to joint area
- Residue that is non-corrosive or, if residue is corrosive, should be easy to clean away after soldering
- Ability to improve wettability (readiness of a metal surface to form an alloy at its interface with the solder) to ensure strong joints with low electrical resistance
- Suitability for the desired method of flux application.

In wave soldering, liquified flux is usually applied as a foam, a spray or in a wave.

Foam

Flux foam is made by forcing low-pressure, water-free clean air through an aerator immersed in liquid flux. Fine bubbles of flux are directed onto the substrate/component surfaces where they burst and form a thin, even layer. The flux also penetrates any plated-through holes. The flux has to be chosen for its foaming capabilities.

Spray

Several methods of spray fluxing exist, the most common involves a mesh drum rotating in liquid flux. Air is blown into the drum which, when passing through the fine mesh, directs a spray of flux onto the underside of the substrate. The amount of flux deposited is controllable by the speed of the substrate passing through the spray, the speed of rotation of the drum and the density of the flux.

Wave

A wave fluxer creates a double flowing wave of liquid flux which adheres to the surface as the substrate passes through. Wave height control is essential and a soft wipe-off brush is usually incorporated to remove excess flux from the substrate.

PRE-HEATING

Pre-heating of the substrate and components is performed immediately before soldering. This reduces thermal shock as the substrate enters the soldering process, causes the flux to become more viscous and accelerates the chemical action of the flux and so speeds up the soldering action.

SOLDERING

Wave soldering is usually the best method to use when high throughput rates are required. The single wave soldering principle (see Fig. 17) is the most straight forward method and can be used on simple substrates with two-terminal SMD components. More complex substrates with increased circuit density and closer spacing of conductors can pose the problems of nonwetting (dry joints) and solder bridging. Bridging can occur across the closely spaced leads of multi-leaded devices as well as across adjacent leads on neighbouring components. Nonwetting is usually caused by components with plastic bodies. The plastic is not wetted by solder and creates a depression in the solder wave, which is augmented by surface tension. This can cause a shadow behind the component and prevent solder from reaching the joint

surfaces. A smooth laminar solder wave is required to avoid bridging and a high pressure wave is needed to completely cover the areas that are difficult to wet. These conflicting demands are difficult to attain in a single wave but dual wave techniques go a long way in overcoming the problem.

In a dual wave machine (see Fig. 18), the substrate first comes into contact with a turbulent wave which has a high vertical velocity. This ensures good solder contact with both edges of the components and prevents joints from being missed. The second smooth laminar wave completes the formation of the solder fillet, removes excess solder and prevents bridging. Figure 19 indicates the time/temperature relationship measured at the soldering site in dual wave soldering.

New methods of wave soldering are developing continually. For example, the Omega System is a single wave agitated by pulses, which combines the functions of smoothness and turbulence. In another, a lambda wave injects air bubbles in the final part of the wave. A further innovation is the hollow jet wave in which the solder wave flows in the opposite direction to the substrate.

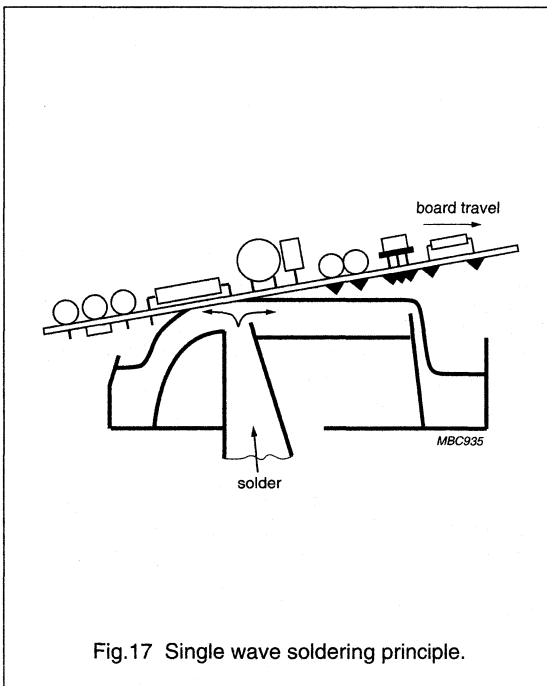


Fig.17 Single wave soldering principle.

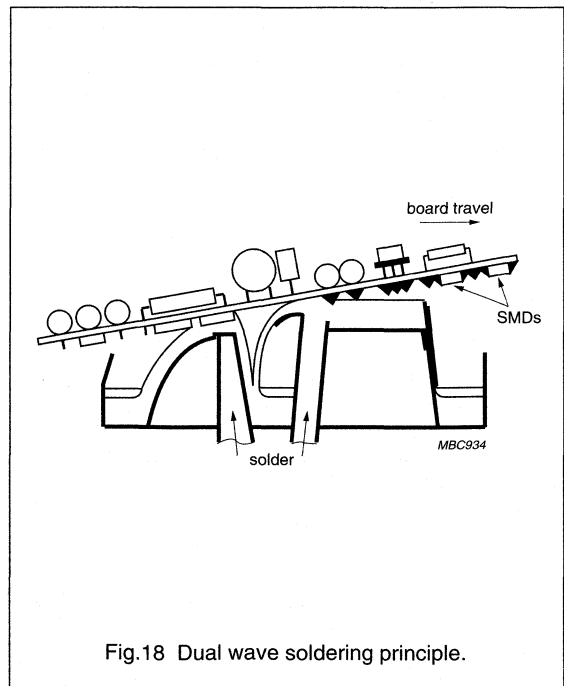
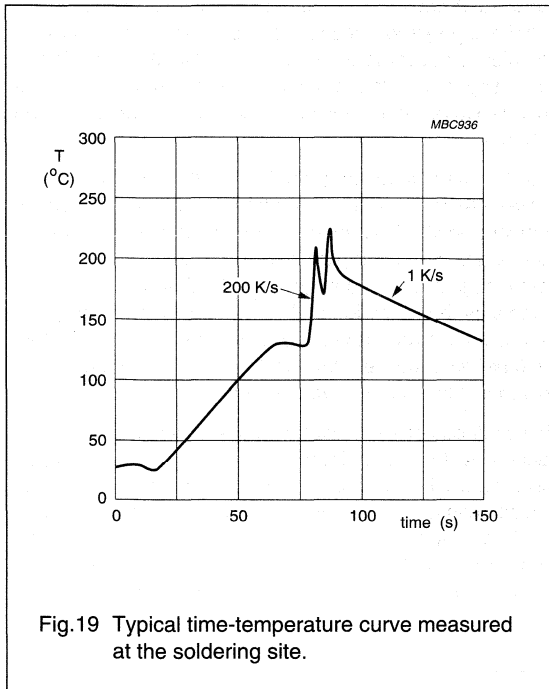


Fig.18 Dual wave soldering principle.

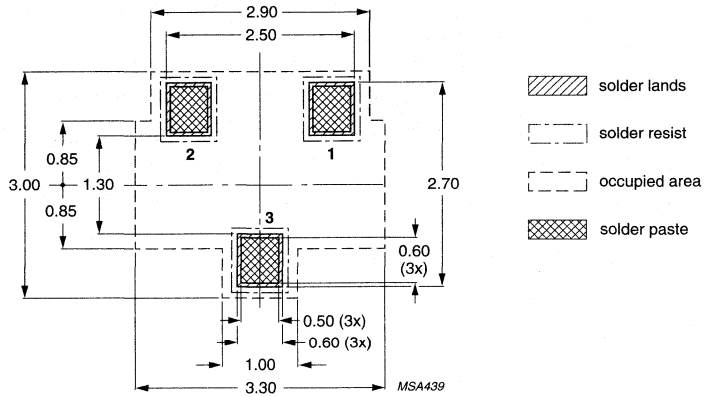


Footprint design

The footprint design of a component for surface mounting is influenced by many factors:

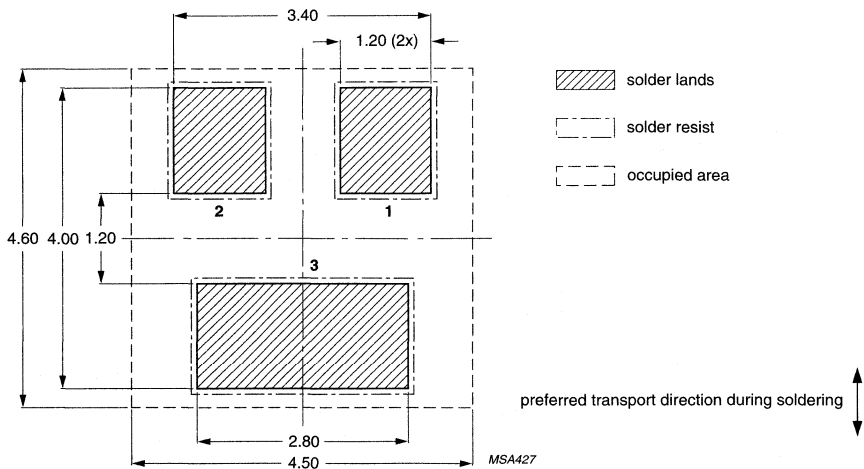
- Features of the component, its dimensions and tolerances
- Circuit board manufacturing processes
- Desired component density
- Minimum spacing between components
- Circuit tracks under the component
- Component orientation (if wave soldering)
- Positional accuracy of solder resist to solder lands (if reflow soldering)
- Component placement accuracy
- Soldering process parameters
- Solder joint reliability parameters.

SOT23 FOOTPRINTS



Dimensions in mm.
Placement accuracy: ± 0.25 mm.

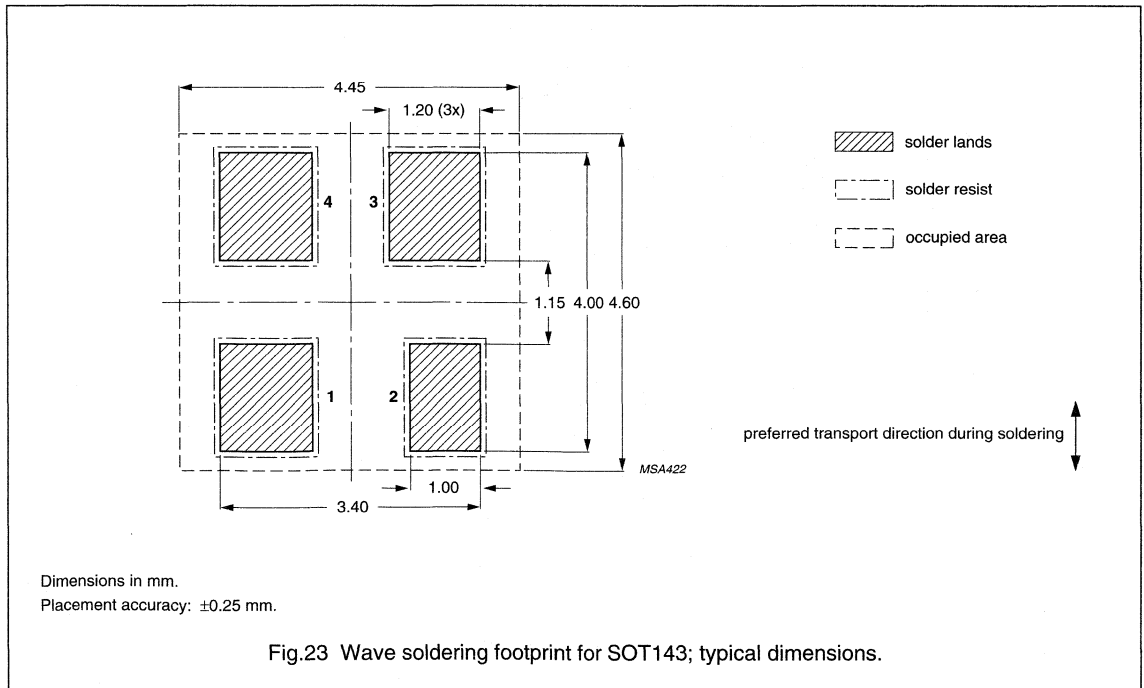
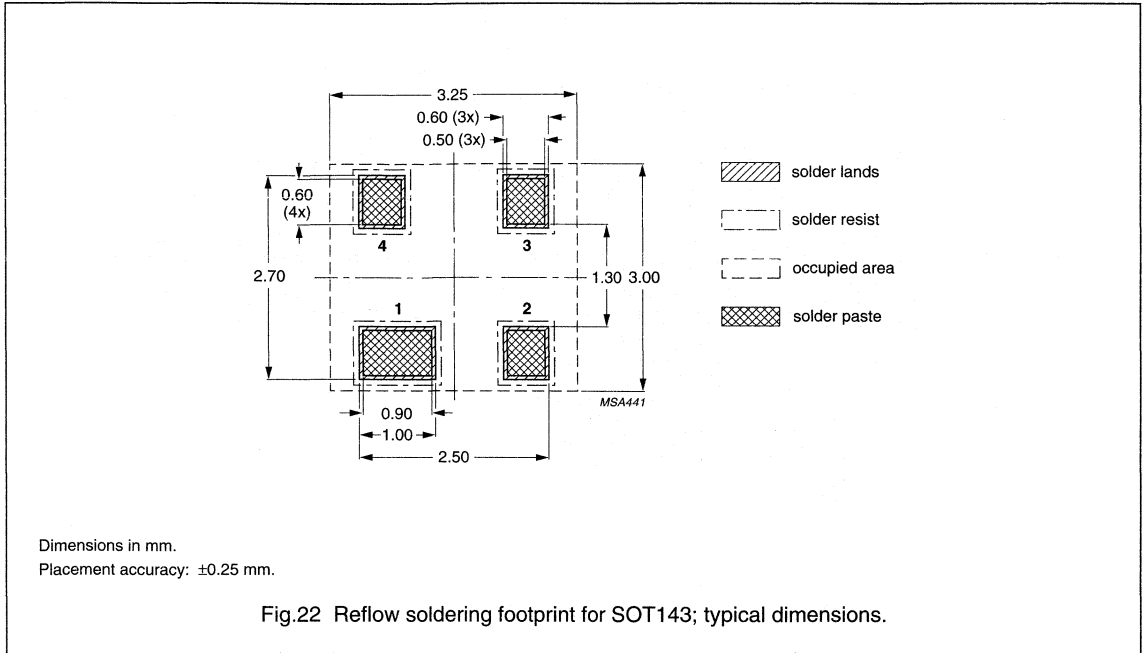
Fig.20 Reflow soldering footprint for SOT23; typical dimensions.



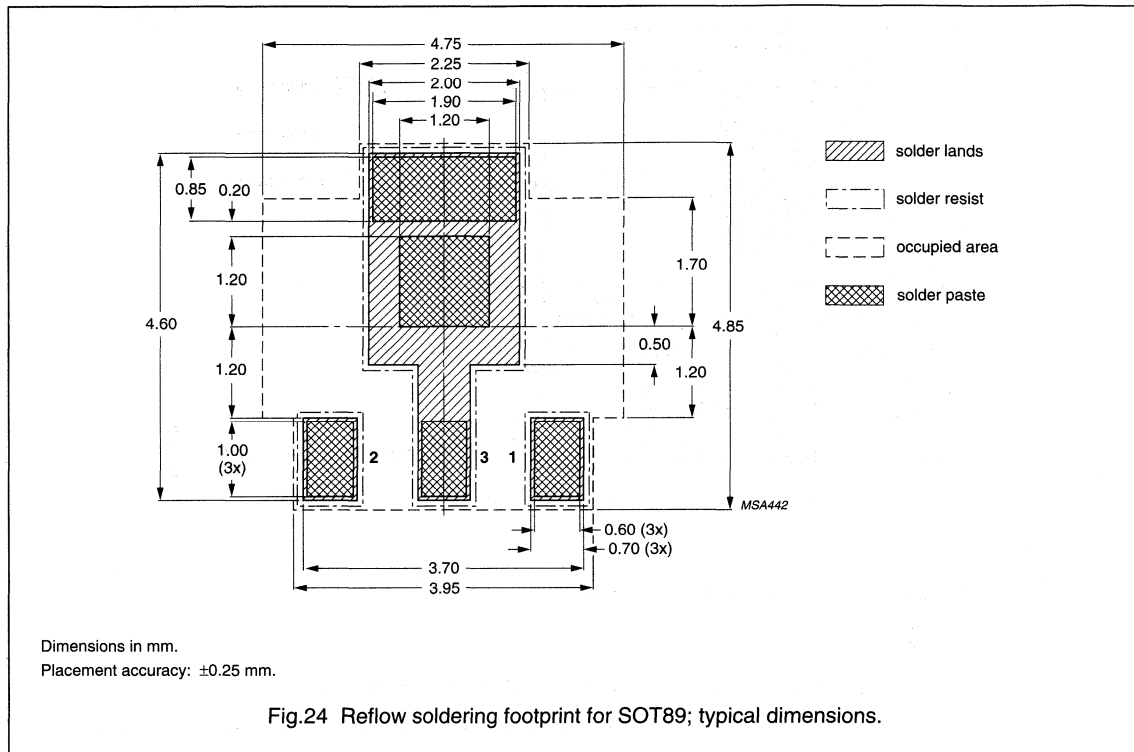
Dimensions in mm.
Placement accuracy: ± 0.25 mm.

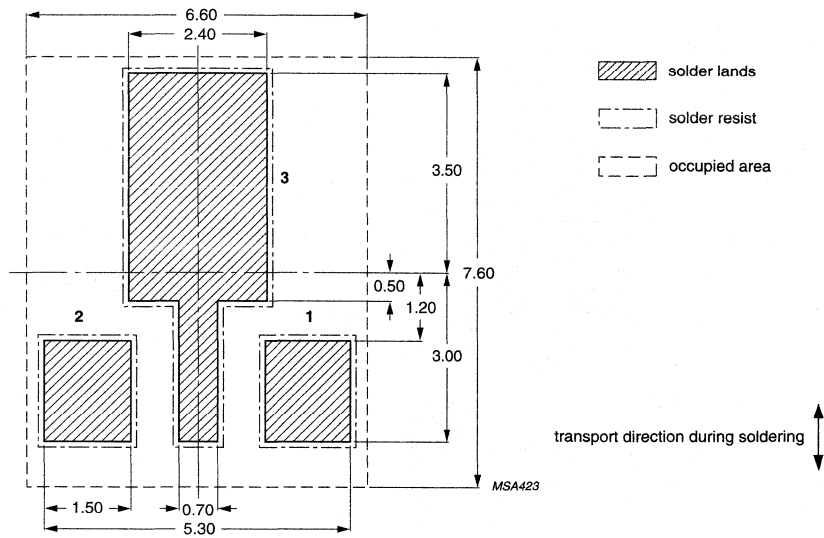
Fig.21 Wave soldering footprint for SOT23; typical dimensions.

SOT143 FOOTPRINTS



SOT89 FOOTPRINTS





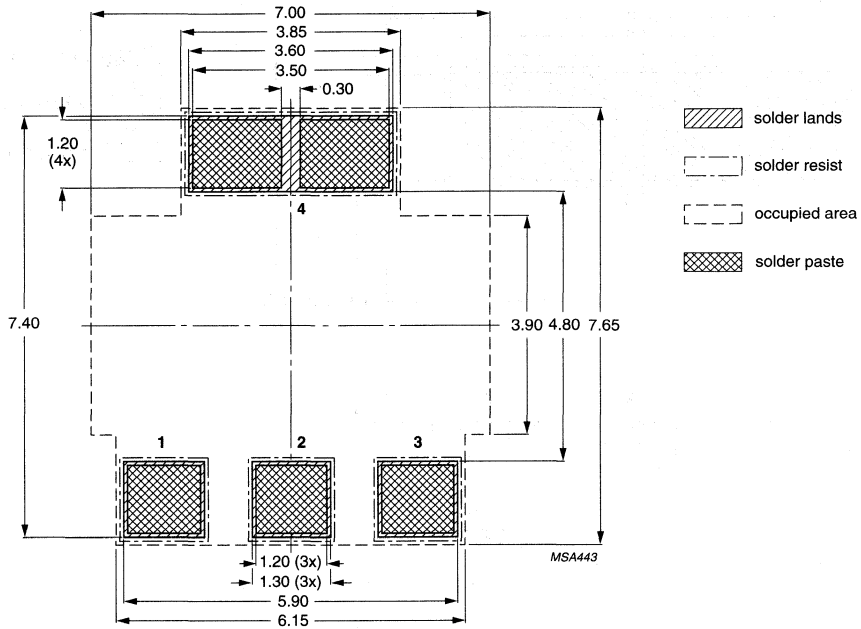
We do not recommend SOT89 for wave soldering, SOT223 is preferred.

Dimensions in mm.

Placement accuracy: ± 0.25 mm.

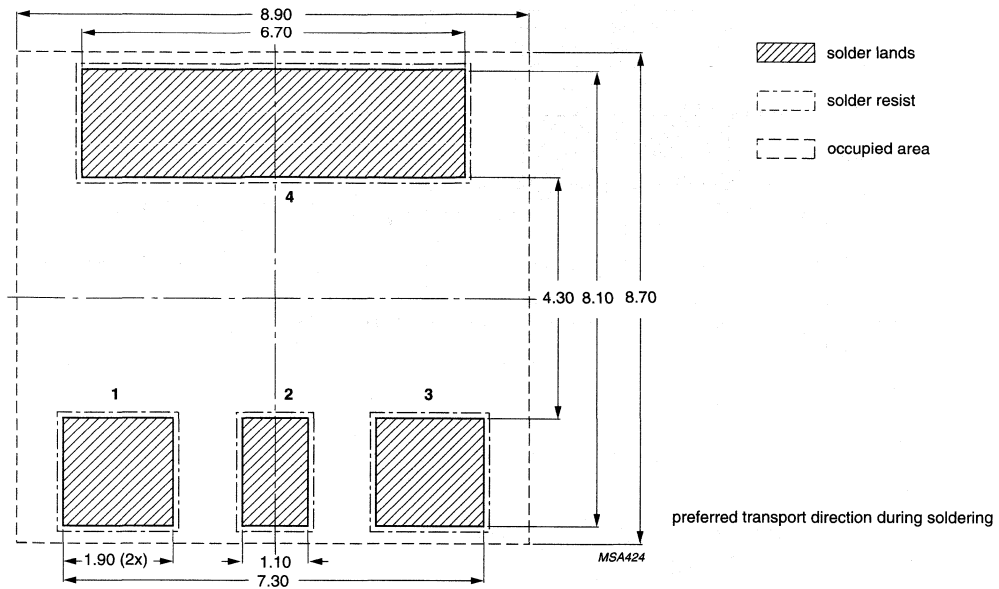
Fig.25 Wave soldering footprint for SOT89: typical dimensions.

SOT223 FOOTPRINTS



Dimensions in mm.
Placement accuracy: ± 0.25 mm.

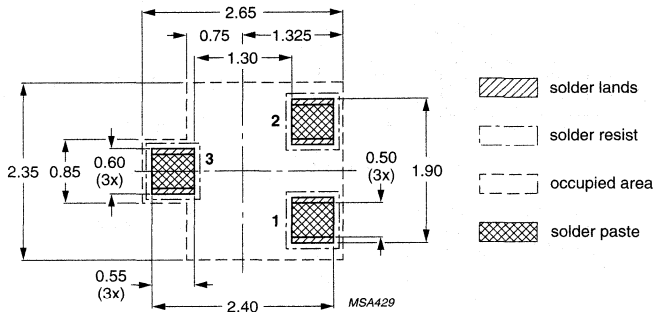
Fig.26 Reflow soldering footprint for SOT223; typical dimensions.



Dimensions in mm.
 Placement accuracy: ± 0.25 mm.

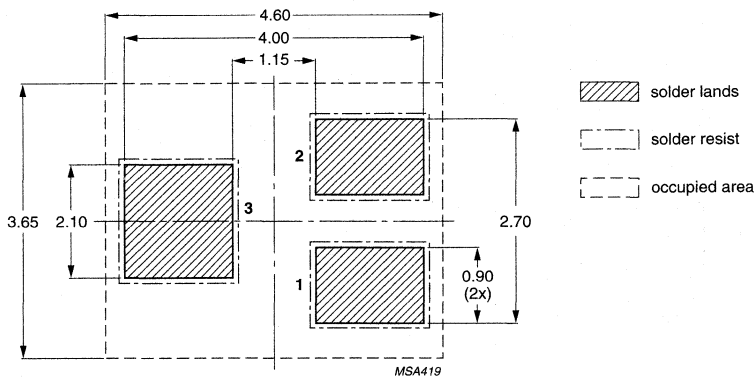
Fig.27 Wave soldering footprint for SOT223; typical dimensions.

SOT323 FOOTPRINTS



Dimensions in mm.
 Placement accuracy: ± 0.25 mm.

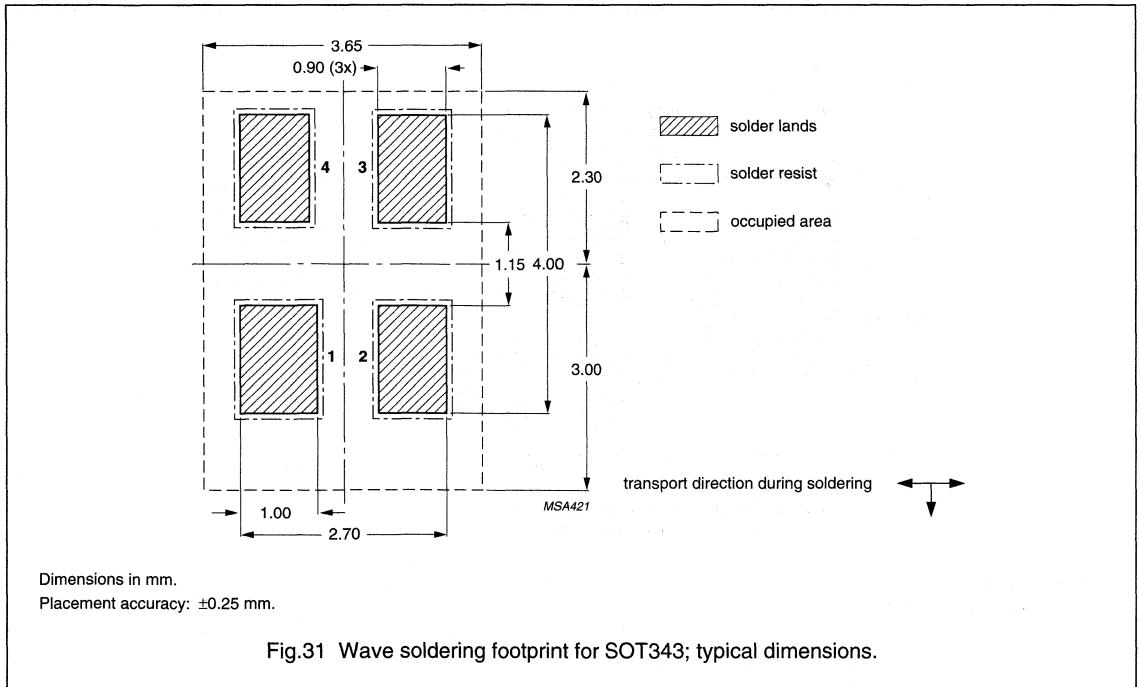
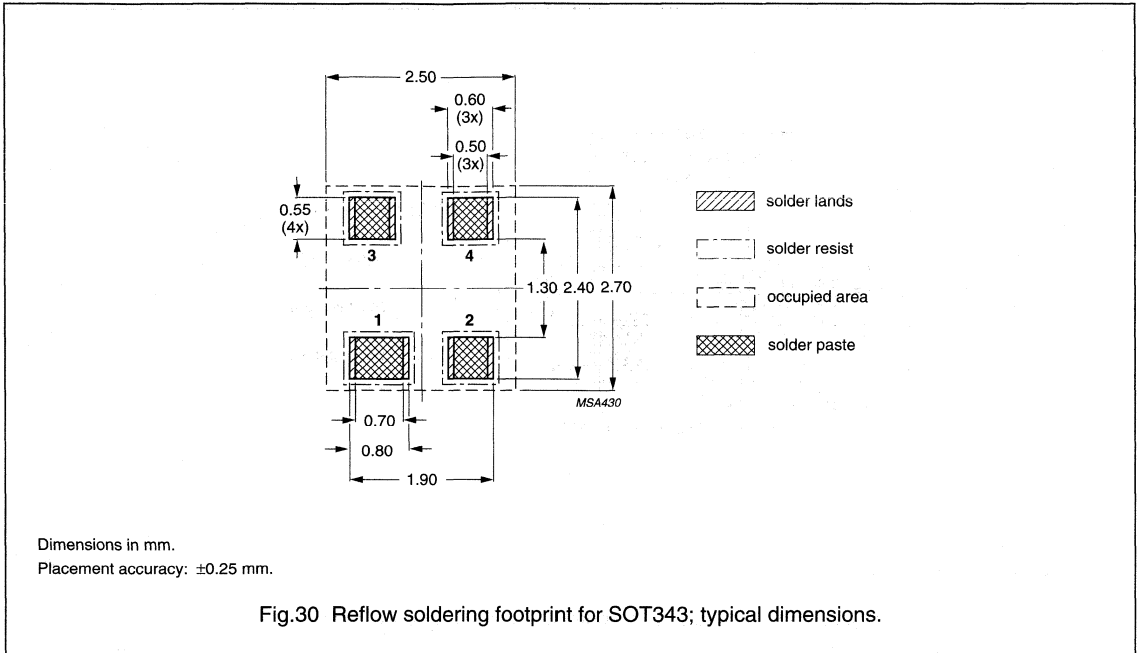
Fig.28 Reflow soldering footprint for SOT323; typical dimensions.



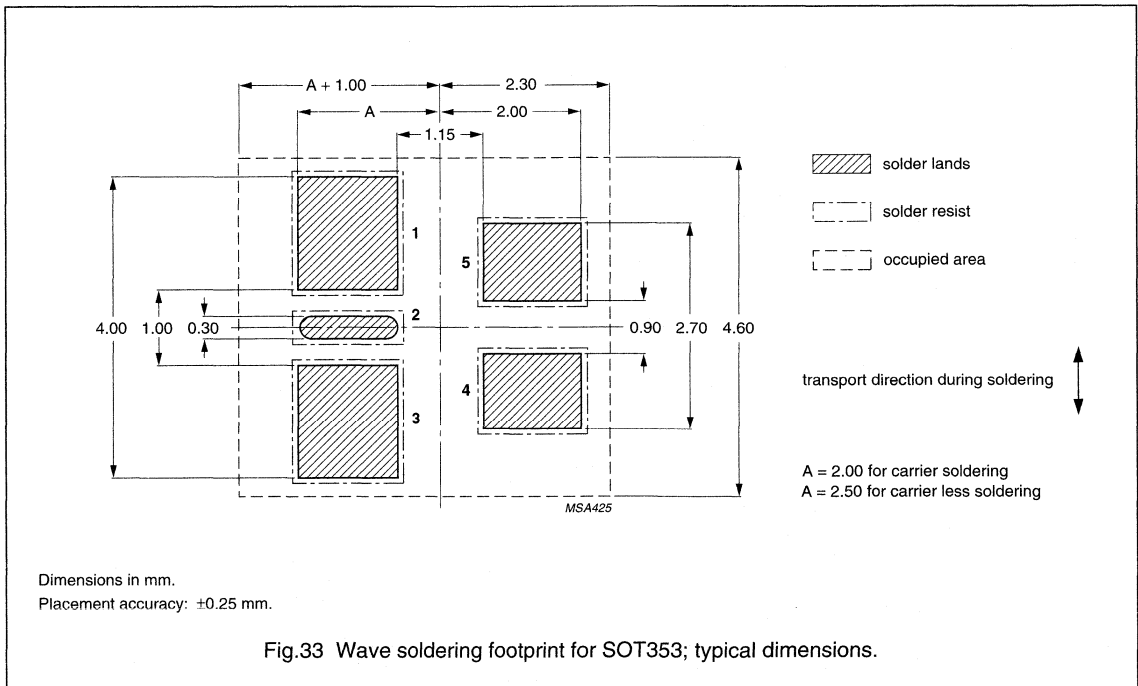
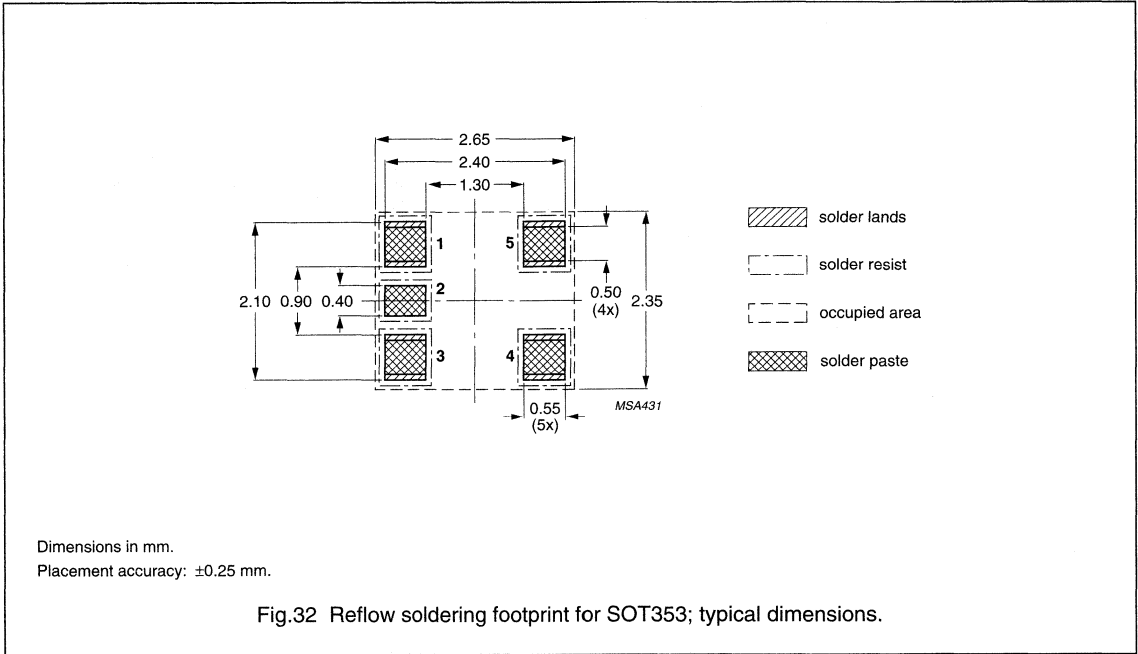
Dimensions in mm.
 Placement accuracy: ± 0.25 mm.

Fig.29 Wave soldering footprint for SOT323; typical dimensions.

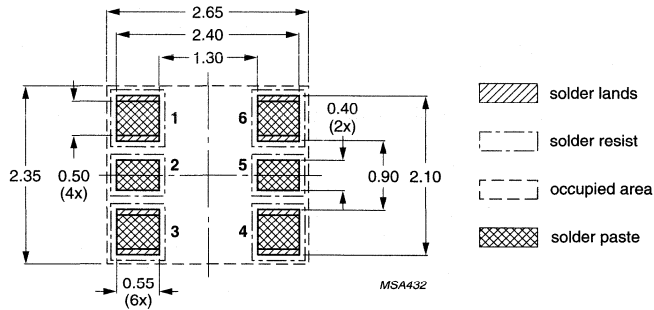
SOT343 FOOTPRINTS



SOT353 FOOTPRINTS

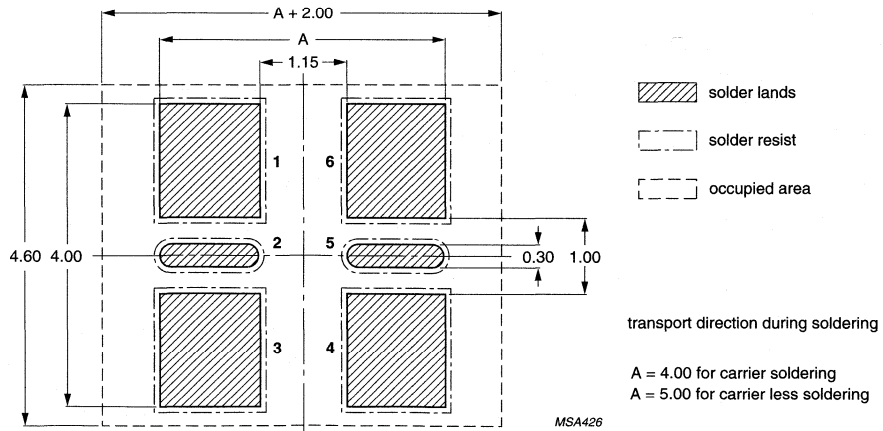


SOT363 FOOTPRINTS



Dimensions in mm.
Placement accuracy: ± 0.25 mm.

Fig.34 Reflow soldering footprint for SOT363; typical dimensions.



Dimensions in mm.
Placement accuracy:

Fig.35 Wave soldering footprint for SOT363; typical dimensions.

Hand soldering microminiature components

It is possible to solder microminiature components with a light-weight hand-held soldering iron, but this method has obvious drawbacks and should be restricted to laboratory use and/or incidental repairs on production circuits:

- Hand-soldering is time-consuming and therefore expensive
- The component cannot be positioned accurately and the connecting tags may come into contact with the substrate and damage it
- There is a risk of breaking the substrate and internal connections in the component could be damaged
- The component package could be damaged by the iron.

THERMAL CONSIDERATIONS

Thermal resistance

Circuit performance and long-term reliability are affected by the temperature of the transistor die. Normally, both are improved by keeping the die temperature (junction temperature) low.

Electrical power dissipated in any semiconductor device is a source of heat. This increases the temperature of the die above a certain reference point. The most relevant reference point of the semiconductor device is the soldering point (i.e. the point on the printed-circuit board where the collector lead is soldered to a heat-draining point see Figs 36 and 37).

The temperature rise as a function of dissipation power, 'thermal resistance', is given in the data sheets as the $R_{th\ j-s}$ value. The heat is drained by conduction via the leadframe, soldering point and substrate (printed-circuit board) to ambient. The amount of radiated and convected heat is negligible in comparison to the conducted heat.

The elements of thermal resistance are defined as follows:

| | |
|---------------|---|
| P_d | Power dissipation (W) |
| $R_{th\ j-s}$ | Thermal resistance from junction to soldering point (K/W) |
| $R_{th\ s-a}$ | Thermal resistance from soldering point to ambient (K/W) |
| $R_{th\ j-a}$ | Thermal resistance from junction to ambient (K/W) |
| T_j | Junction temperature of the die (°C) |
| T_s | Soldering point temperature (°C) |
| T_{amb} | Ambient temperature (°C) |
| T_{ref} | Temperature of the reference point (°C) |

The peak temperature of the die depends on the ability of the package and its mounting to transfer heat from this die to ambient environment (see Fig.38). The basic relationship between die temperature (junction temperature) and power dissipation is:

$$T_{j\ max} = T_{amb} + P_{d\ max} \times [R_{th\ j-s} + R_{th\ s-a}]$$

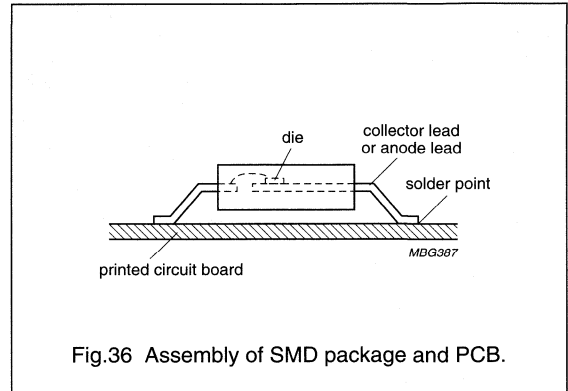


Fig.36 Assembly of SMD package and PCB.

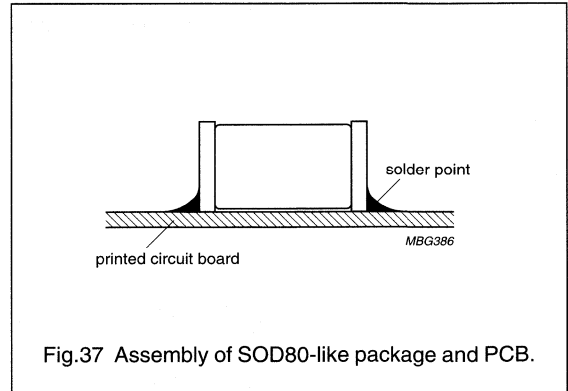


Fig.37 Assembly of SOD80-like package and PCB.

Thermal resistance from junction to soldering point [$R_{th(j-s)}$]

In the example for $T_{j\ max}$, only T_{amb} and $R_{th\ s-a}$ can be varied by the user. The construction of the printed-circuit board (PCB) and the ambient condition (as there is air flow) affect $R_{th\ s-a}$. The device power dissipation can be controlled to a limited extent, under recommended usage. The supply voltage and circuit loading dictate a fixed power maximum. The $R_{th\ j-s}$ value is essentially independent of external mounting method and cooling air, but is sensitive to the materials used in the package construction, the die mount and the die area, all of which are fixed.

Values of $T_{j\max}$ and $R_{th\ j-s}$, or $R_{th\ j-c}$ are given in the device data sheets. For applications where T_s is known, T_j can be calculated from:

$$T_j = T_s + P_d \times R_{th\ j-s}$$

Thermal resistance from soldering point to ambient [$R_{th\ s-a}$]

There is a limiting value for the soldering point temperature. For the normal tin alloy (Sn-Pb 60% - 40%): $T_{s\max} = 110\text{ }^\circ\text{C}$. The value of T_s can be calculated from:

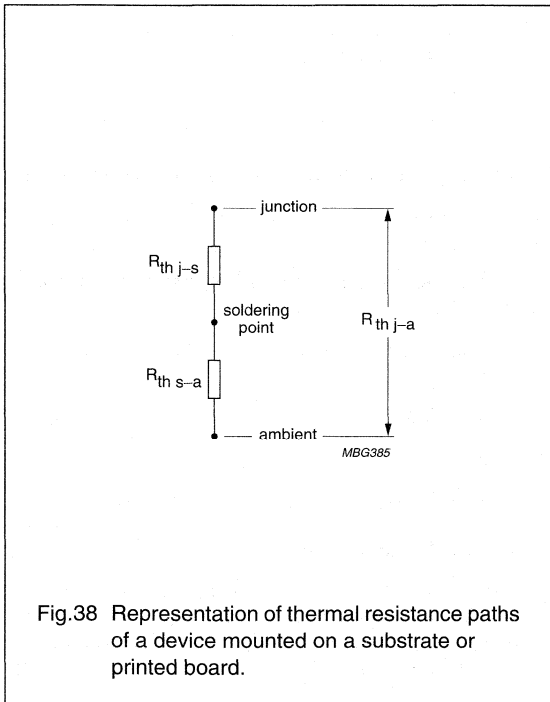
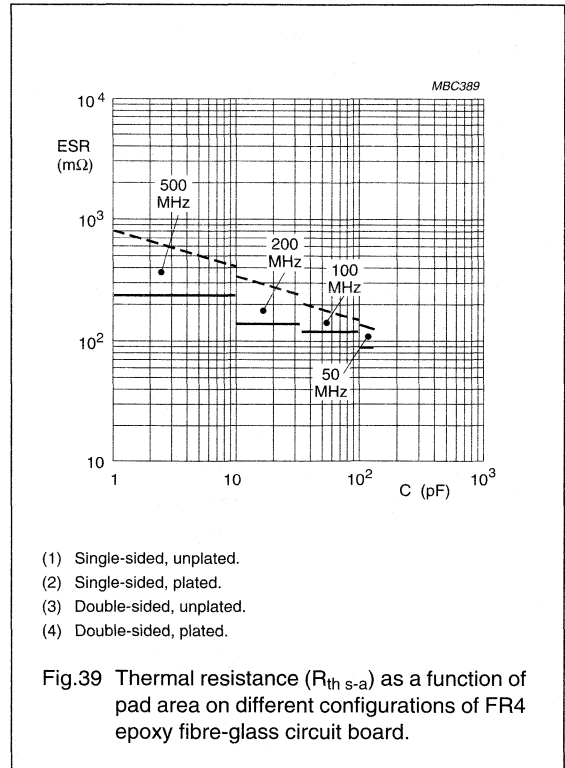
$$T_s = T_a + P_d \times R_{th\ s-a}$$

The thermal resistance from soldering point to ambient depends on the shape and material of the tracks on a printed-circuit board as illustrated in Fig.39.

Summary of the SMD envelopes

These thermal considerations are valid for the following envelopes:

- SOD80, SOD87, SOD106, SOD110, SOD123, SOD323,
- SC59, SC70, SOT23, SOT89, SOT123, SOT143,
- SOT223, SOT323, SOT343, SOT346 and SO8 (SOT96-1).



Temperature calculation under pulsed conditions

In pulsed power conditions, the peak temperature of the die depends on the pulse time and duty factor as well as the ability of the package and its mounting to disperse heat.

When power is applied in repetitive square-wave pulses with a certain duty factor (δ), the variation in junction temperature has a sawtooth characteristic.

The average steady-state junction temperature is:

$$T_{j(av)} = T_{ref} + \delta \times P_d \times R_{th\ j-ref}$$

The peak junction temperature, however, is the most relevant to performance reliability. This can be calculated by heating and cooling step functions that result in heating and cooling curves shifted in time as shown in Fig.40.

The peak value of T_j is reached at the end of a power pulse and the minimum value immediately before the next power pulse. The thermal ripple is the difference between $T_{j(peak)}$ and $T_{j(min)}$.

Calculation of $T_{j(peak)}$ after n pulses:

$$T_{j(\text{peak})} = T_{\text{ref}} + P_d \times \sum_{a=0}^{a=n-1} [Z_{\text{th}(at-w)} - Z_{\text{th}(at)}]$$

where a is an integer number.

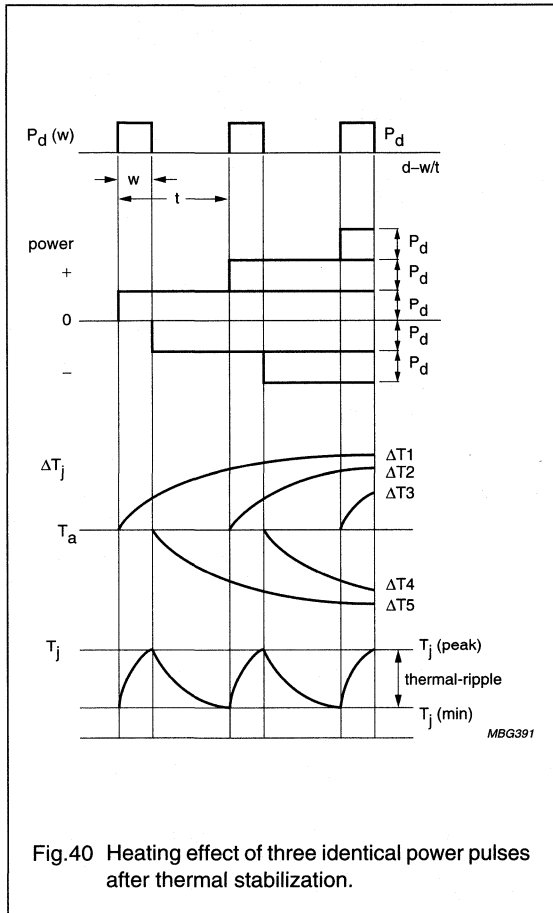


Fig.40 Heating effect of three identical power pulses after thermal stabilization.

Approximation method of finding $T_{j(\text{peak})}$

With this method it is assumed that the average load is immediately followed by two square power pulses as shown in Fig.41. This two-pulse approximation method is accurate enough for finding $T_{j(\text{peak})}$.

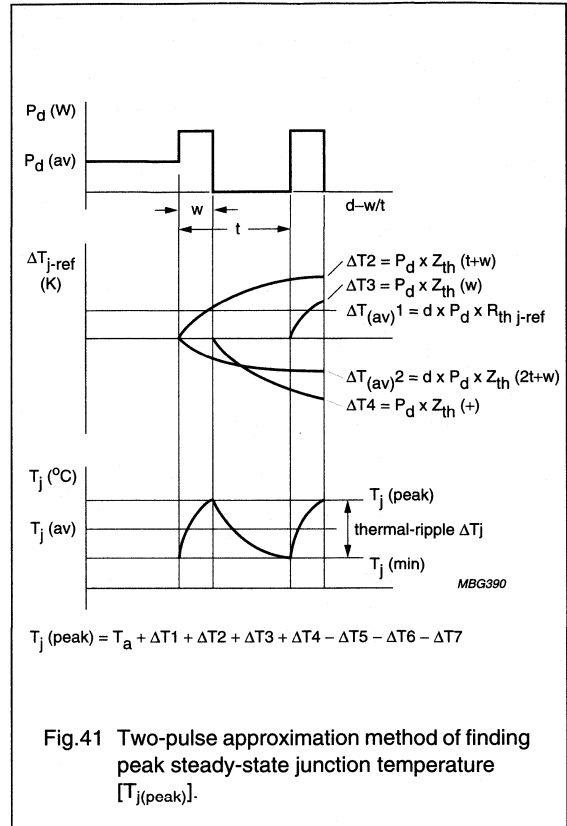


Fig.41 Two-pulse approximation method of finding peak steady-state junction temperature $[T_{j(\text{peak})}]$.

The junction temperature at the end of the second pulse is:

$$T_{j(\text{peak})} = T_{\text{ref}} + P_d \times [\delta \times R_{\text{th}(j-\text{ref})} + (1 - \delta) \times Z_{\text{th}(t+w)} + Z_{\text{th}(w)} - Z_{\text{th}(t)}]$$

The junction temperature immediately before the second power pulse is:

$$T_{j(\text{min})} = T_{\text{ref}} + P_d \times [\delta \times R_{\text{th}(j-\text{ref})} + (1 - \delta) \times Z_{\text{th}(t)} + Z_{\text{th}(w)} - Z_{\text{th}(t-w)}]$$

The thermal ripple is:

$$\Delta T_j = T_{j(\text{peak})} - T_{j(\text{min})}$$

$$\Delta T_j = P_d \times [\delta \times (Z_{\text{th}(t)} - Z_{\text{th}(t+w)}) - 2 \times Z_{\text{th}(t)} + Z_{\text{th}(w)} + Z_{\text{th}(t-w)}]$$

Reducing calculation time

To be able to point out the junction peak temperature at a certain pulse time and duty cycle, a graph similar to that shown in Fig.42 is included in relevant data sheets. In this example, the curves have been derived using the formula

RF Wideband Transistors

General section

$$T_{j(\text{peak})} = T_{\text{ref}} + P_d \times [\delta \times R_{\text{th}(j-\text{ref})} + (1 - \delta) \times Z_{\text{th}(t+w)} + Z_{\text{th}(w)} - Z_{\text{th}(t)}], \text{ with typical values inserted.}$$

The pulse width along the X-axis meets a particular duty cycle curve, indicating the Z_{th} value in K/W along the Y-axis.

$$T_{j(\text{peak})} = P_{d(\text{peak})} \times Z_{\text{th}(j-s)} + P_{d(\text{av})} \times R_{\text{th}(s-a)} + T_a \text{ (}^\circ\text{C)}$$

Soldering point temperature provides a better reference point than ambient temperature as this is subject to many uncontrolled variables. Therefore, the thermal resistance from junction to soldering point [$R_{\text{th}(j-s)}$] is becoming a more relevant measurement path.

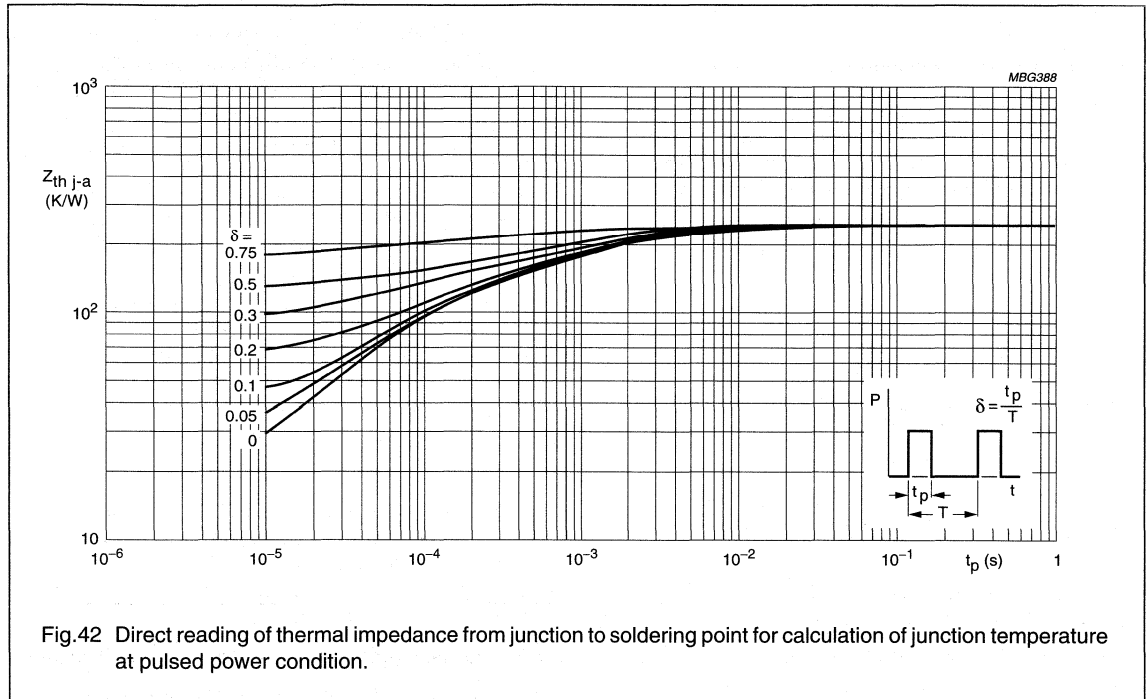


Fig.42 Direct reading of thermal impedance from junction to soldering point for calculation of junction temperature at pulsed power condition.

ELECTROSTATIC CHARGES

Electrostatic charges can exist in many things; for example, man-made-fibre clothing, moving machinery, objects with air blowing across them, plastic storage bins, sheets of paper stored in plastic envelopes, paper from electrostatic copying machines, and people. The charges are caused by friction between two surfaces, at least one of which is non-conductive. The magnitude and polarity of the charges depend on the different affinities for electrons of the two materials rubbing together, the friction force and the humidity of the surrounding air.

Electrostatic discharge is the transfer of an electrostatic charge between bodies at different potentials and occurs with direct contact or when induced by an electrostatic field. Our devices **can** be damaged if the following precautions are not taken.

WORK STATION

Figure 43 shows a working area suitable for safely handling electrostatic sensitive devices. It has a work bench, the surface of which is conductive or covered by an antistatic sheet. Typical resistivity for the bench surface is between 1 and 500 k Ω per cm². The floor should also be covered with antistatic material.

The following precautions should be observed:

- Persons at a work bench should be earthed via a wrist strap and a resistor
- All mains-powered electrical equipment should be connected via an earth leakage switch
- Equipment cases should be earthed
- Relative humidity should be maintained between 50 and 65%
- An ionizer should be used to neutralize objects with immobile static charges.

RECEIPT AND STORAGE

Our devices are packed for dispatch in antistatic/conductive containers, usually boxes, tubes or blister tape. The fact that the contents are sensitive to electrostatic discharge is shown by warning labels on both primary and secondary packing.

The devices should be kept in their original packing whilst in storage. If a bulk container is partially unpacked, the unpacking should be performed at a protected work station. Any devices that are stored temporarily should be packed in conductive or antistatic packing or carriers.

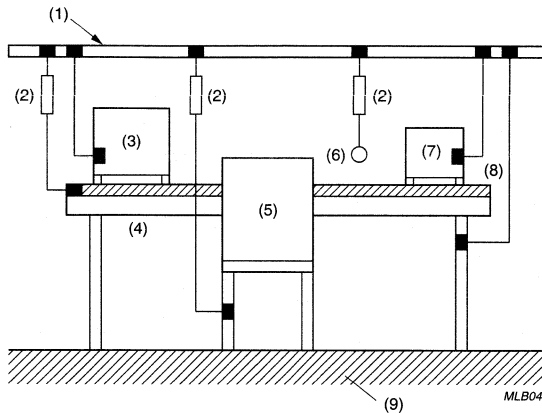
ASSEMBLY

The devices must be removed from their protective packing with earthed component pincers or short-circuit clips. Short-circuit clips must remain in place during mounting, soldering and cleansing/drying processes. Do not remove more devices from the storage packing than are needed at any one time. Production/assembly documents should state that the product contains electrostatic sensitive devices and that special precautions need to be taken.

All tools used during assembly, including soldering tools and solder baths, must be earthed. All hand tools should be of conductive or antistatic material and, where possible, should not be insulated.

Measuring and testing of completed circuit boards must be done at a protected work station. Place the soldered side of the circuit board on conductive or antistatic foam and remove the short-circuit clips. Remove the circuit board from the foam, holding the board only at the edges. Make sure the circuit board does not touch the conductive surface of the work bench. After testing, replace the circuit board on the conductive foam to await packing.

Assembled circuit boards should be handled in the same way as unmounted devices. They should also carry warning labels and be packed in conductive or antistatic packing.



- (1) Earthing rail.
- (2) Resistor ($500\text{ k}\Omega \pm 10\%$, 0.5 W).
- (3) Ionizer.
- (4) Work bench.
- (5) Chair.
- (6) Wrist strap.
- (7) Electrical equipment.
- (8) Conductive surface/antistatic sheet.
- (9) Antistatic floor.

Fig.43 Protected work station.

APPLICATION INFORMATION

APPLICATION REPORTS

Copies of the following application reports are available on the enclosed CD-ROM

1. Power Amplifier for 1.9 GHz at 3 V (BFG10/X, BFG11/X and BFG540/X), "*RNR45/458/1992, 29 September 1993*" (3rd version). Application information of a surface mount RF power amplifier for 1.9 GHz Digital Personal Handy Phone and DECT at 3 V.
2. Low Noise 900 MHz preamplifier at 3 V with BFR/BFG505/520, "*RNR45/589/1992, 17 December 1992*".
3. Low Noise, Low Current preamplifier for 1.9 GHz at 3 V (BFG505), "*RNR45/343/1992, 16 July 1992*".
4. 933 MHz Low Power Down converter with 60 MHz IF (BFG505/X, BFG520 and BFG540/X), "*RNR45/465/1993, 30 September 1993*".
5. 1890 MHz Low Power Down converter with 110 MHz IF (BFG505, BFG505/X and BFG520), "*RNR45/465/1993, 26 January 1994*" (2nd version).
6. Preamplifier for pager applications (BFC505), "*RNR-T45-95-B-341, 22 May 1995*".
7. GSM Power Amplifier for 900 MHz at 6 V (BFG540W/X, BFG10W/X, BLT82). Application information of a 3.5 W surface mount RF power amplifier in the 880 to 915 MHz communication band, 31 January 1995.
8. Ultra Low Noise Amplifiers for 900 and 2000 MHz with High IP3. (BFG410 W and BFG425W), "*KV96-157, December 1996*".
9. Power Amplifier for 1.9 GHz Dect and PHS (BFG425W and BFG21W) "*RNR-T45-96T-838*", 15 October 1996.

DEVICE DATA

in alphanumeric sequence

NPN 1 GHz wideband transistor

BF547

FEATURES

- Feedback capacitance typ. 1 pF
- Stable oscillator operation
- High current gain
- Good thermal stability.

APPLICATIONS

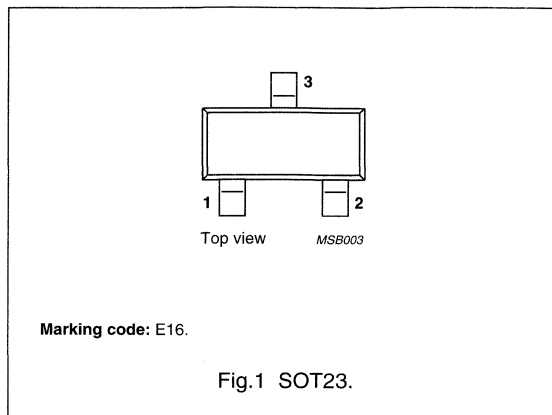
- It is intended for VHF and UHF TV-tuner applications and can be used as a mixer and/or oscillator.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |

DESCRIPTION

Low cost NPN transistor in a plastic SOT23 package.



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | – | 20 | V |
| V_{CB0} | collector-base voltage | open emitter | – | 30 | V |
| V_{EB0} | emitter-base voltage | open collector | – | 3 | V |
| I_{CM} | peak collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$ | 1.2 | 1.6 | GHz |
| C_{re} | feedback capacitance | $I_E = I_e = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | 1 | – | pF |

Note

1. T_s is the temperature at the soldering point of the collector pin.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|---|------|------|------------------|
| V_{CE0} | collector-emitter voltage | open base | – | 20 | V |
| V_{CB0} | collector-base voltage | open emitter | – | 30 | V |
| V_{EB0} | emitter-base voltage | open collector | – | 3 | V |
| I_{CM} | peak collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature range | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 150 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 1 GHz wideband transistor

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THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|----------------------------------|------------|-------|------|
| $R_{th\ j-s}$ | from junction to soldering point | note 1 | 260 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

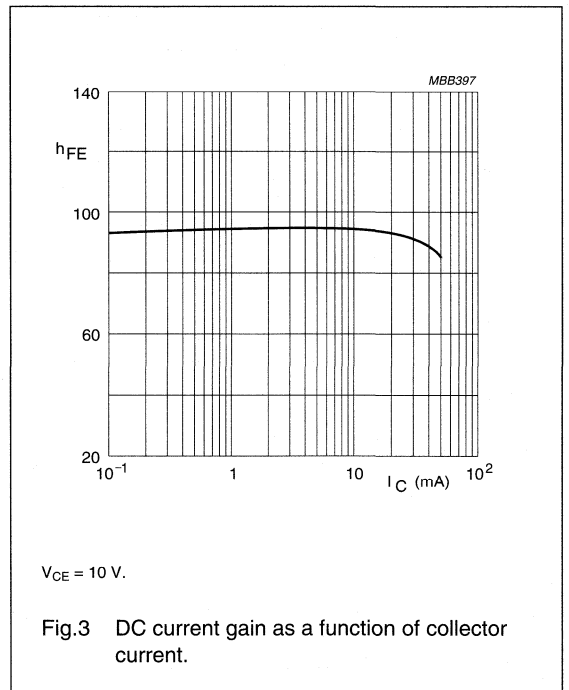
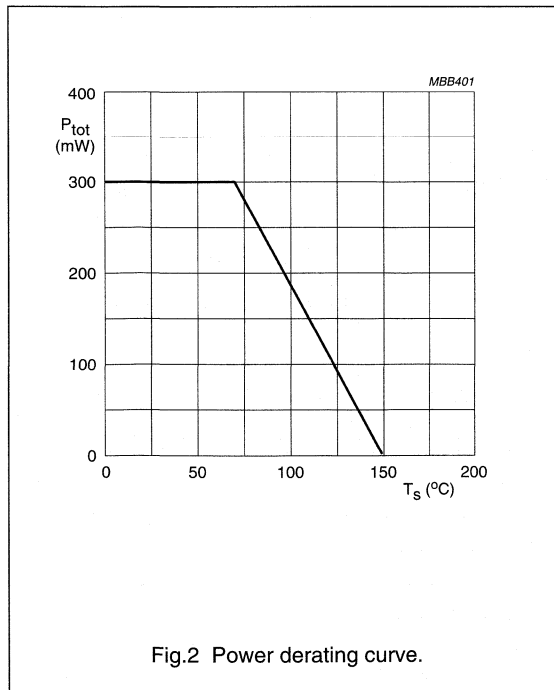
CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------------------|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 10\text{ V}$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}; V_{CE} = 10\text{ V}$ | 40 | 95 | 250 | |
| f_T | transition frequency | $I_C = 15\text{ mA}; V_{CE} = 10\text{ V}; f = 500\text{ MHz}$ | 0.8 | 1.2 | 1.6 | GHz |
| C_{re} | feedback capacitance | $I_E = i_e = 0; V_{CB} = 10\text{ V}; f = 1\text{ MHz}$ | – | 1 | – | pF |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 1\text{ mA}; V_{CE} = 10\text{ V}; f = 100\text{ MHz}$ | – | 20 | – | dB |

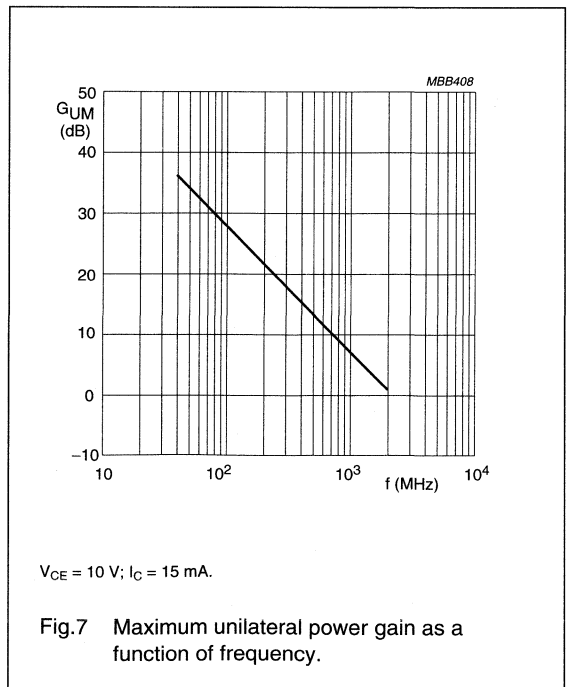
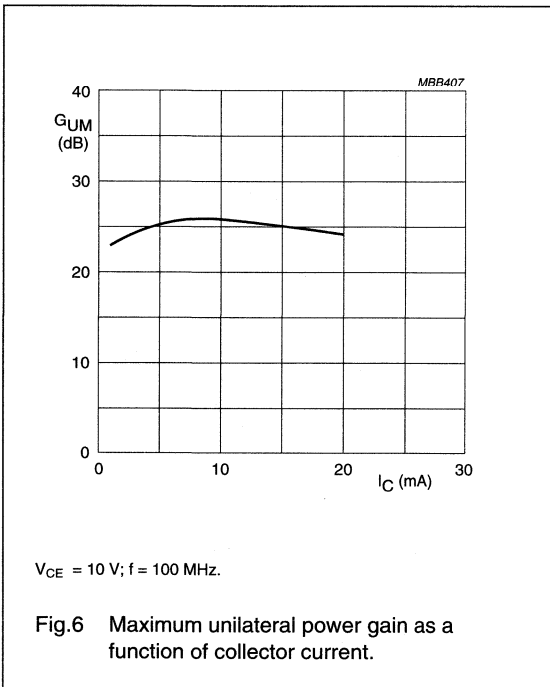
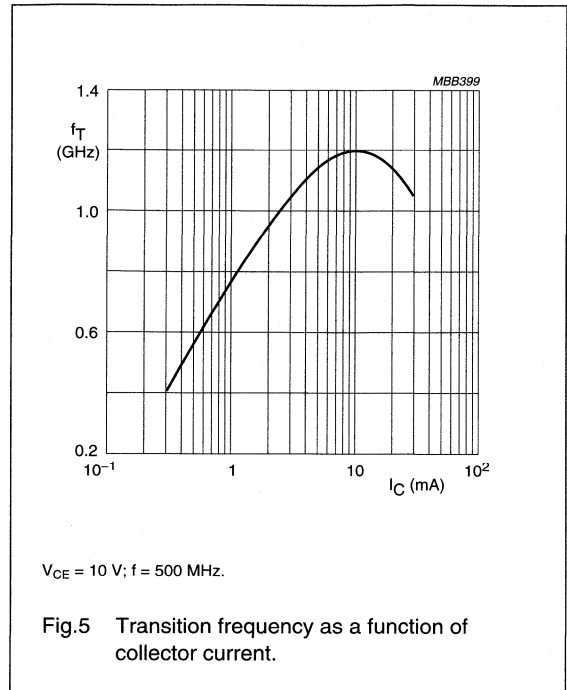
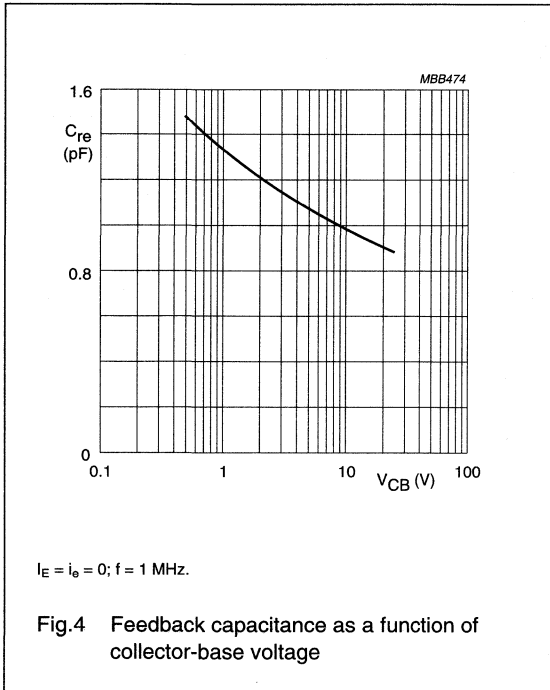
Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB.



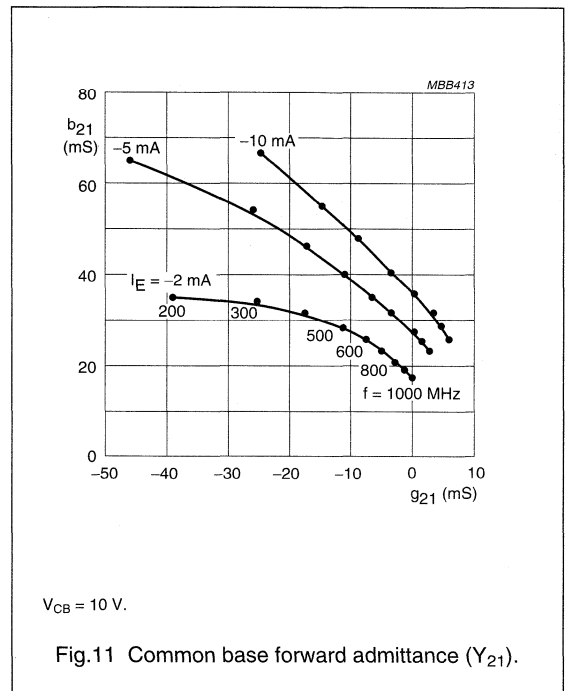
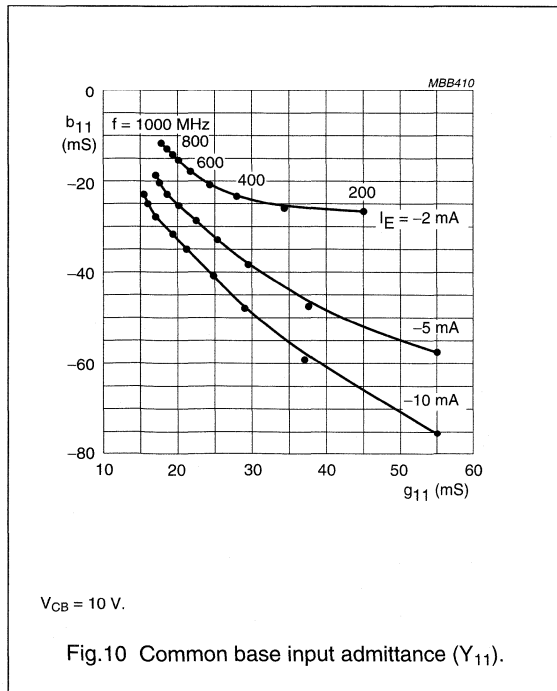
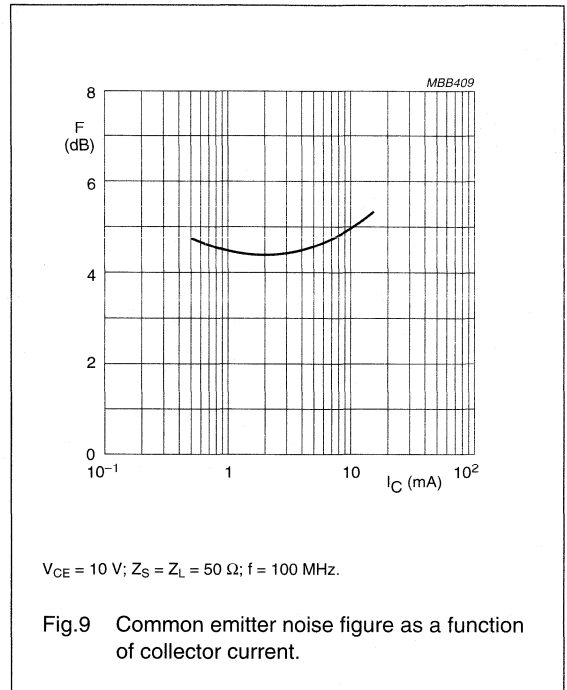
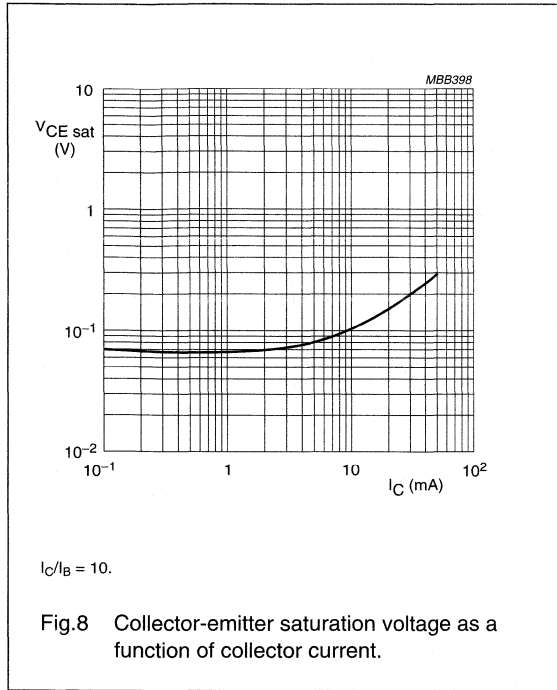
NPN 1 GHz wideband transistor

BF547



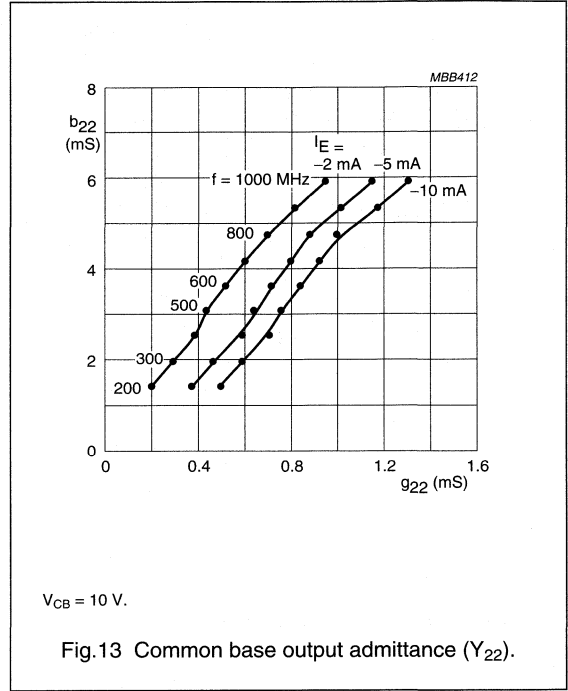
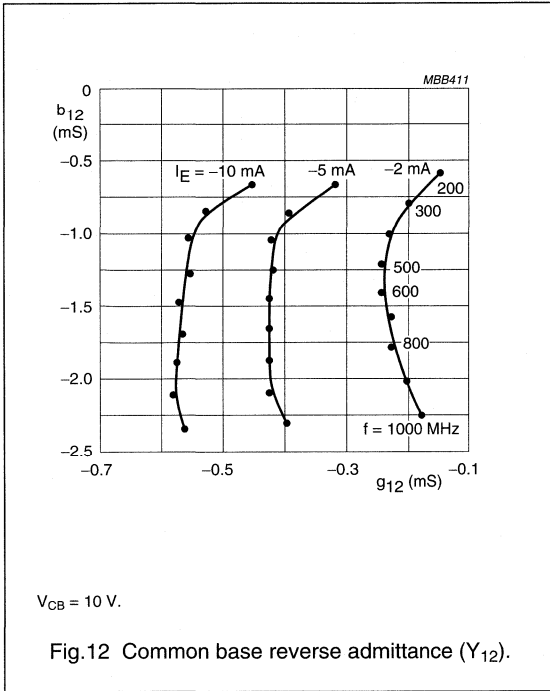
NPN 1 GHz wideband transistor

BF547



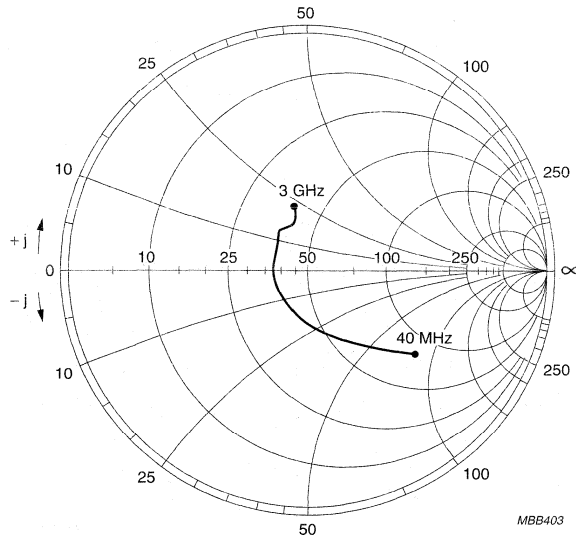
NPN 1 GHz wideband transistor

BF547



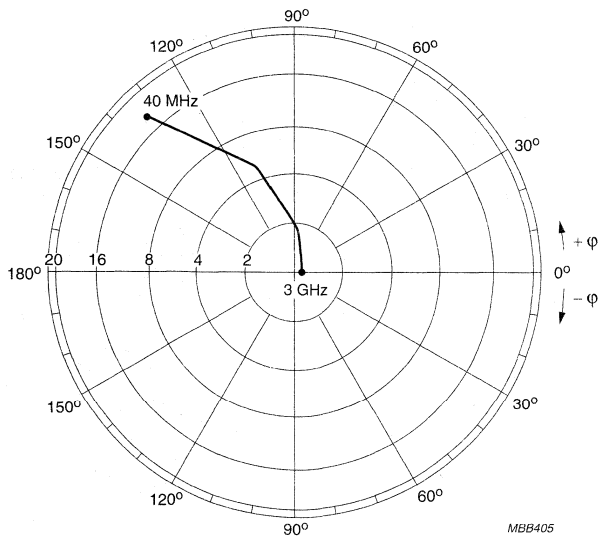
NPN 1 GHz wideband transistor

BF547



$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}; Z_O = 50\ \Omega.$

Fig.14 Common emitter input reflection coefficient (S_{11}).

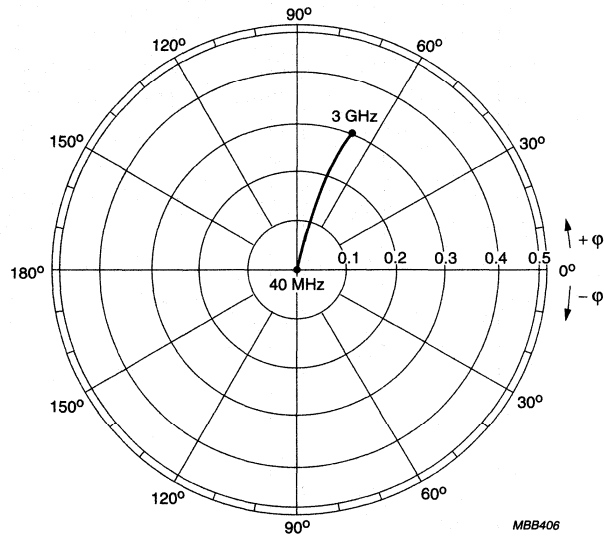


$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}.$

Fig.15 Common emitter forward transmission coefficient (S_{21}).

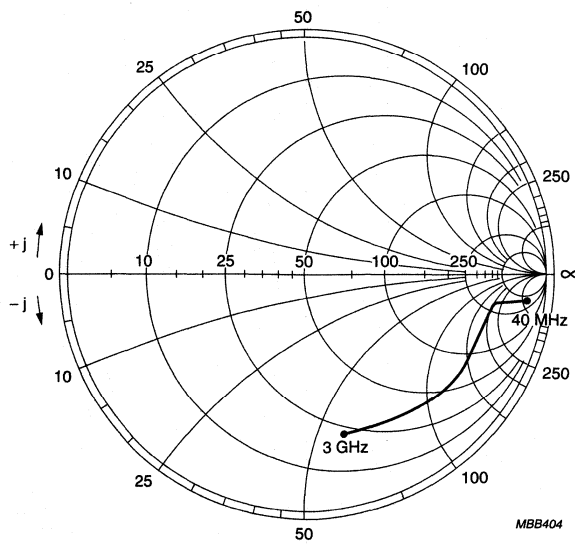
NPN 1 GHz wideband transistor

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$V_{CE} = 10 \text{ V}; I_C = 15 \text{ mA}$.

Fig.16 Common emitter reverse transmission coefficient (S_{12}).



$V_{CE} = 10 \text{ V}; I_C = 15 \text{ mA}; Z_O = 50 \Omega$.

Fig.17 Common emitter output reflection coefficient (S_{22}).

NPN 1 GHz wideband transistor

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Table 1 Common base Y-parameters; $V_{CB} = 10\text{ V}$; $I_E = -2\text{ mA}$

| f (MHz) | Y ₁₁ | | Y ₂₁ | | Y ₁₂ | | Y ₂₂ | |
|---------|-----------------|------------|-----------------|------------|-----------------|------------|-----------------|------------|
| | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) |
| 40 | 69.0 | -10.2 | -68.0 | 12.3 | -0.02 | -0.1 | -0.01 | 0.3 |
| 100 | 60.4 | -20.6 | -58.0 | 25.6 | -0.06 | -0.3 | -0.08 | 0.7 |
| 200 | 45.0 | -27.4 | -39.1 | 34.5 | -0.10 | -0.6 | 0.19 | 1.4 |
| 300 | 34.3 | -26.4 | -25.4 | 34.0 | -0.20 | -0.8 | 0.29 | 1.9 |
| 400 | 27.7 | -23.3 | -17.2 | 31.1 | -0.20 | -1.0 | 0.37 | 2.5 |
| 500 | 24.0 | -20.4 | -11.7 | 27.6 | -0.20 | -1.2 | 0.45 | 3.0 |
| 600 | 21.5 | -18.0 | -7.8 | 25.0 | -0.20 | -1.4 | 0.53 | 3.6 |
| 700 | 20.0 | -15.6 | -5.3 | 22.6 | -0.20 | -1.6 | 0.60 | 4.2 |
| 800 | 18.6 | -14.0 | -3.0 | 20.2 | -0.20 | -1.8 | 0.69 | 4.7 |
| 900 | 18.3 | -12.8 | -1.3 | 18.7 | -0.20 | -2.0 | 0.82 | 5.3 |
| 1000 | 17.8 | -11.7 | -0.1 | 17.1 | -0.20 | -2.2 | 0.95 | 5.9 |

Table 2 Common base Y-parameters; $V_{CB} = 10\text{ V}$; $I_E = -5\text{ mA}$

| f (MHz) | Y ₁₁ | | Y ₂₁ | | Y ₁₂ | | Y ₂₂ | |
|---------|-----------------|------------|-----------------|------------|-----------------|------------|-----------------|------------|
| | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) |
| 40 | 132.6 | -35.7 | -130.5 | 38.8 | -0.06 | -0.2 | -0.06 | 0.4 |
| 100 | 96.3 | -62.0 | -91.1 | 67.9 | -0.20 | -0.5 | 0.21 | 0.8 |
| 200 | 54.7 | -57.8 | -46.0 | 64.7 | -0.30 | -0.7 | 0.38 | 1.4 |
| 300 | 37.5 | -46.9 | -26.4 | 53.8 | -0.40 | -0.8 | 0.47 | 2.0 |
| 400 | 29.2 | -38.6 | -16.6 | 45.8 | -0.40 | -1.0 | 0.58 | 2.5 |
| 500 | 25.3 | -32.8 | -11.0 | 39.8 | -0.40 | -1.3 | 0.63 | 3.1 |
| 600 | 22.0 | -28.4 | -6.3 | 35.0 | -0.40 | -1.4 | 0.71 | 3.6 |
| 700 | 20.3 | -25.2 | -3.3 | 31.4 | -0.40 | -1.6 | 0.80 | 4.2 |
| 800 | 18.7 | -22.6 | -0.6 | 27.6 | -0.40 | -1.9 | 0.88 | 4.7 |
| 900 | 17.8 | -20.7 | 1.4 | 25.2 | -0.40 | -2.1 | 1.01 | 5.3 |
| 1000 | 17.3 | -19.1 | 3.0 | 23.0 | -0.40 | -2.3 | 1.15 | 6.0 |

NPN 1 GHz wideband transistor

BF547

Table 3 Common base Y-parameters; $V_{CB} = 10\text{ V}$; $I_E = -10\text{ mA}$

| f (MHz) | Y ₁₁ | | Y ₂₁ | | Y ₁₂ | | Y ₂₂ | |
|---------|-----------------|------------|-----------------|------------|-----------------|------------|-----------------|------------|
| | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) |
| 40 | 189.0 | -79.6 | -185.5 | 83.0 | -0.10 | -0.3 | -0.09 | 0.4 |
| 100 | 108.5 | -99.0 | -101.4 | 105.4 | -0.30 | -0.5 | 0.30 | 0.9 |
| 200 | 55.2 | -76.2 | -44.6 | 82.8 | -0.50 | -0.7 | 0.44 | 1.4 |
| 300 | 37.1 | -59.0 | -24.3 | 65.7 | -0.50 | -0.9 | 0.60 | 2.0 |
| 400 | 28.8 | -47.6 | -14.6 | 54.4 | -0.60 | -1.0 | 0.69 | 2.5 |
| 500 | 24.7 | -40.2 | -8.6 | 46.7 | -0.60 | -1.3 | 0.75 | 3.1 |
| 600 | 21.2 | -35.0 | -3.4 | 40.8 | -0.60 | -1.5 | 0.84 | 3.6 |
| 700 | 19.3 | -31.0 | -0.2 | 36.2 | -0.60 | -1.7 | 0.93 | 4.2 |
| 800 | 17.2 | -27.5 | 2.6 | 31.1 | -0.60 | -1.9 | 1.00 | 4.7 |
| 900 | 16.4 | -25.2 | 4.6 | 28.3 | -0.60 | -2.1 | 1.15 | 5.3 |
| 1000 | 15.8 | -23.0 | 6.0 | 25.5 | -0.60 | -2.3 | 1.31 | 6.0 |

Table 4 Common base Y-parameters; $V_{CB} = 10\text{ V}$; $I_E = -15\text{ mA}$

| f (MHz) | Y ₁₁ | | Y ₂₁ | | Y ₁₂ | | Y ₂₂ | |
|---------|-----------------|------------|-----------------|------------|-----------------|------------|-----------------|------------|
| | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) |
| 40 | 206.5 | -113.8 | -202.6 | 118.1 | -0.20 | -0.3 | 0.2 | 0.5 |
| 100 | 104.3 | -114.0 | -96.4 | 120.1 | -0.40 | -0.5 | 0.4 | 0.9 |
| 200 | 53.1 | -81.1 | -41.7 | 87.7 | -0.50 | -0.7 | 0.6 | 1.4 |
| 300 | 35.9 | -62.1 | -22.0 | 68.6 | -0.60 | -0.8 | 0.7 | 2.0 |
| 400 | 28.1 | -50.0 | -12.5 | 56.9 | -0.60 | -1.1 | 0.8 | 2.5 |
| 500 | 23.4 | -42.3 | -6.1 | 48.2 | -0.60 | -1.3 | 0.8 | 3.1 |
| 600 | 20.1 | -36.4 | -1.2 | 41.6 | -0.60 | -1.5 | 0.9 | 3.6 |
| 700 | 18.2 | -32.0 | 2.0 | 36.7 | -0.60 | -1.7 | 1.0 | 4.2 |
| 800 | 16.2 | -28.2 | 4.5 | 31.3 | -0.60 | -1.9 | 1.1 | 4.7 |
| 900 | 15.5 | -25.7 | 6.5 | 28.1 | -0.60 | -2.1 | 1.3 | 5.3 |
| 1000 | 14.7 | -23.5 | 7.9 | 24.9 | -0.60 | -2.3 | 1.4 | 5.9 |

NPN 1 GHz wideband transistor

BF547W

FEATURES

- Stable oscillator operation
- High current gain
- Good thermal stability.

APPLICATIONS

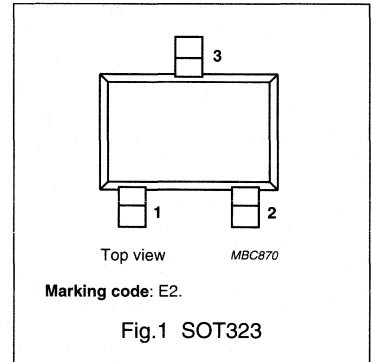
It is primarily intended as a mixer, oscillator and IF amplifier in UHF and VHF tuners.

DESCRIPTION

Silicon NPN transistor in a plastic SOT323 (S-mini) package. The BF547W uses the same crystal as the SOT23 version, BF547.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 30 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 20 | V |
| I_C | collector current (DC) | | – | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 63\text{ °C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}$; $V_{CE} = 10\text{ V}$ | 40 | 95 | 250 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 1 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$ | 0.8 | 1.2 | 1.6 | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 1\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 100\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 20 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 30 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 20 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| I_C | collector current (DC) | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 63\text{ °C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | +150 | °C |

Note to the “Quick reference data” and “Limiting values”

1. T_s is the temperature at the soldering point of the collector pin.

NPN 1 GHz wideband transistor

BF547W

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|-------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 63\text{ °C}$; note 1 | 290 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ °C}$ (unless otherwise specified).

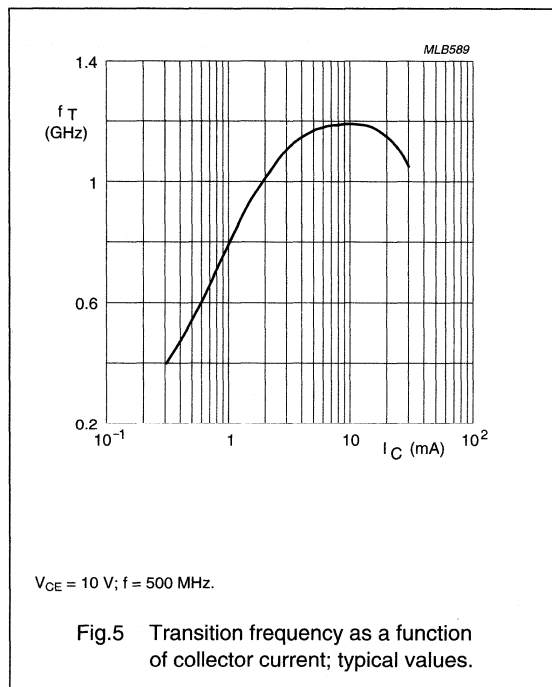
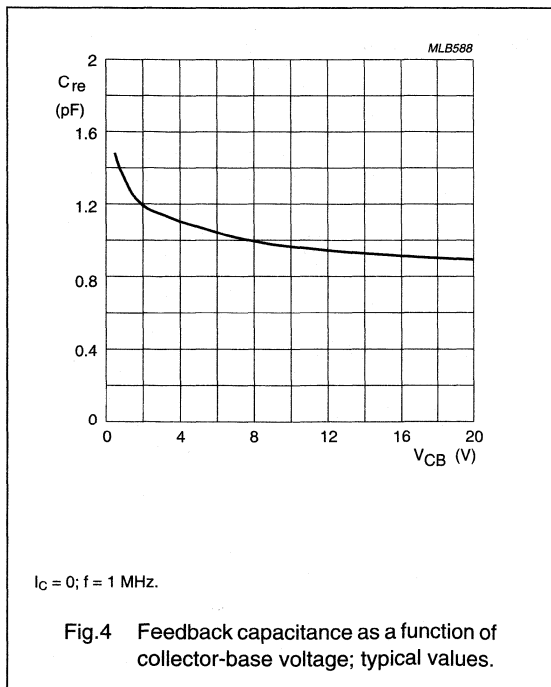
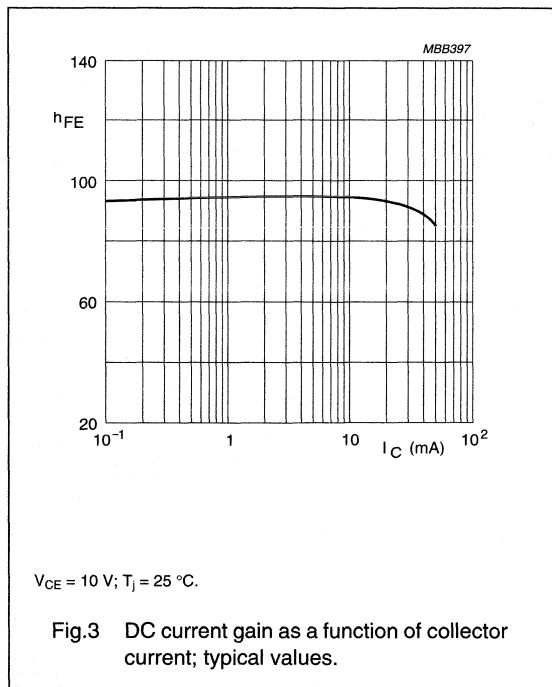
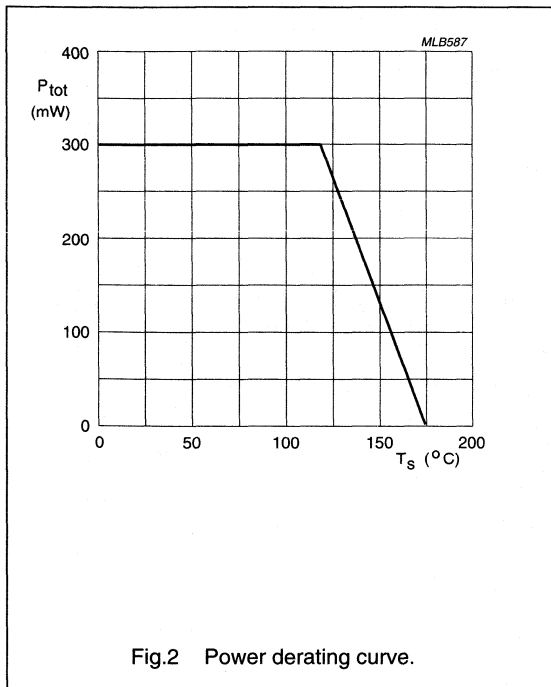
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|--|---|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 0.01\text{ mA}$; $I_E = 0$ | – | – | 30 | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 10\text{ mA}$; $I_B = 0$ | – | – | 20 | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 0.01\text{ mA}$; $I_C = 0$ | – | – | 3 | V |
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}$; $V_{CE} = 10\text{ V}$ | 40 | 95 | 250 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 1 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$ | 0.8 | 1.2 | 1.6 | GHz |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 1\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 100\text{ MHz}$; $T_{amb} = 25\text{ °C}$; | – | 20 | – | dB |

Note

- G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

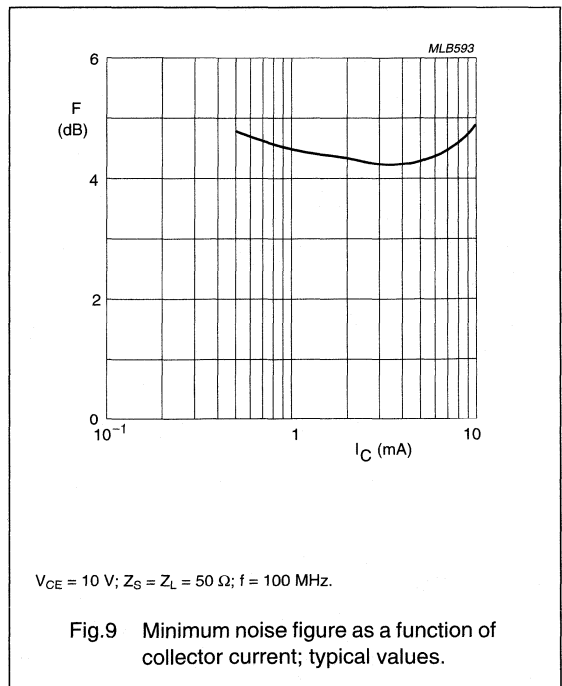
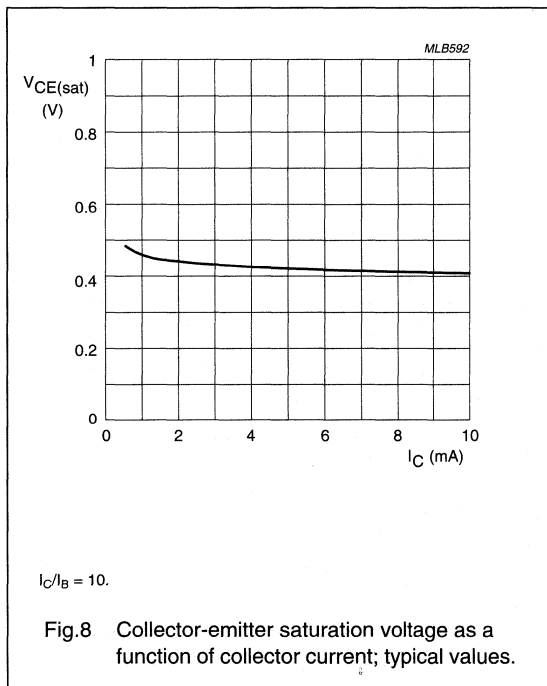
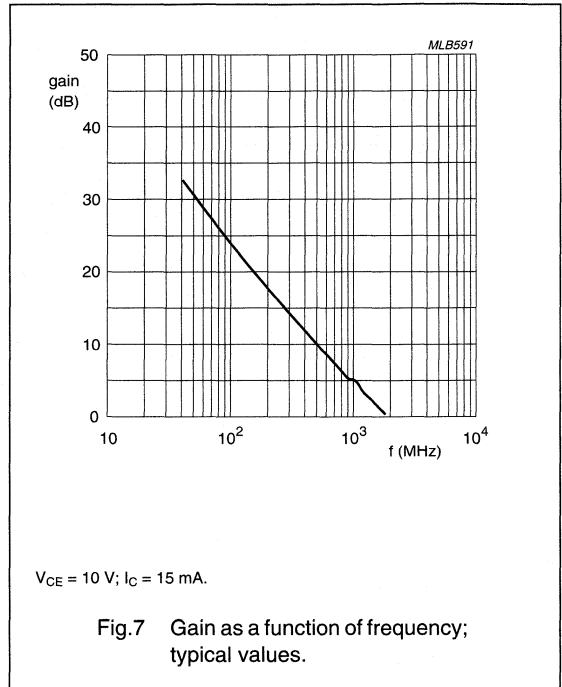
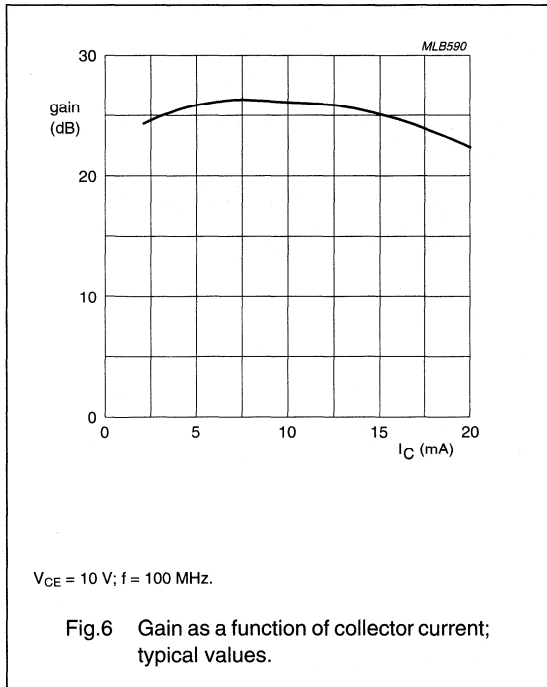
NPN 1 GHz wideband transistor

BF547W



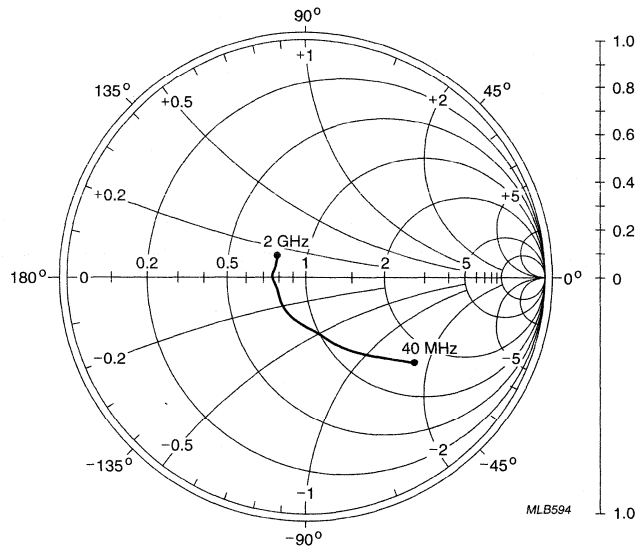
NPN 1 GHz wideband transistor

BF547W



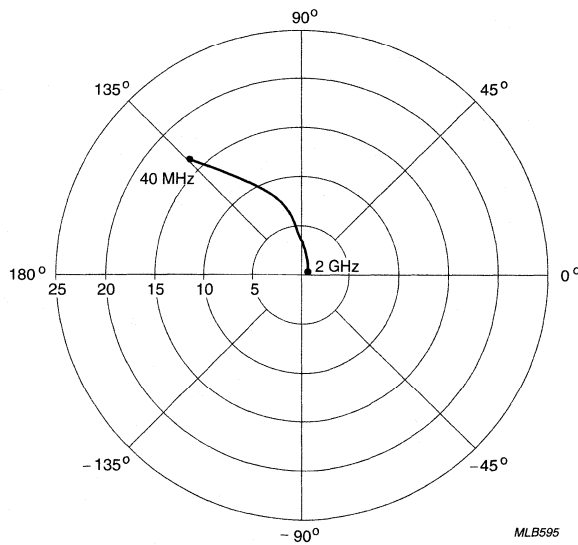
NPN 1 GHz wideband transistor

BF547W



$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}; Z_o = 50\ \Omega.$

Fig.10 Common emitter input reflection coefficient (s_{11}); typical values.

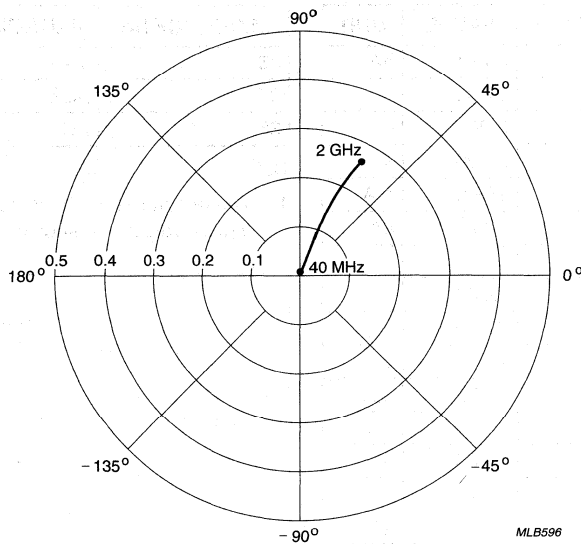


$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}.$

Fig.11 Common emitter forward transmission coefficient (s_{21}); typical values.

NPN 1 GHz wideband transistor

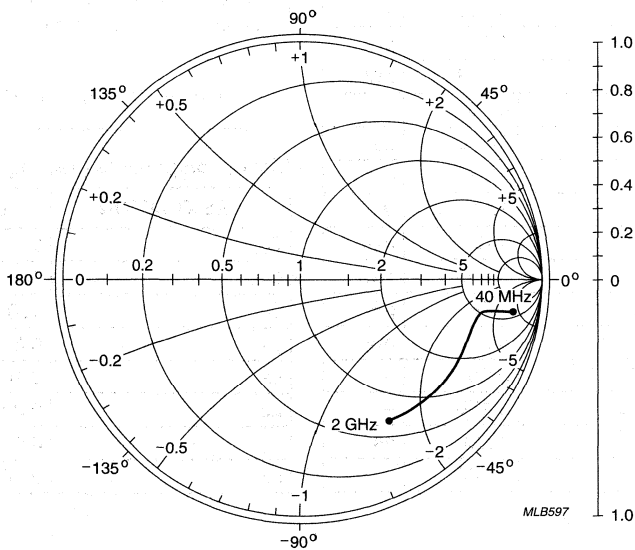
BF547W



$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}$.

MLB596

Fig.12 Common emitter reverse transmission coefficient (s_{12}); typical values.



$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}; Z_0 = 50\ \Omega$.

MLB597

Fig.13 Common emitter output reflection coefficient (s_{22}); typical values.

NPN 1 GHz wideband transistor

BF547W

SPICE parameters for the BF547W crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|----------|
| 1 | IS | 289.1 | aA |
| 2 | BF | 94.29 | — |
| 3 | NF | 0.989 | — |
| 4 | VAF | 90.00 | V |
| 5 | IKF | 158.6 | mA |
| 6 | ISE | 426.6 | aA |
| 7 | NE | 1.491 | — |
| 8 | BR | 12.32 | — |
| 9 | NR | 0.989 | — |
| 10 | VAR | 19.39 | V |
| 11 | IKR | 24.75 | mA |
| 12 | ISC | 249.7 | pA |
| 13 | NC | 1.200 | — |
| 14 | RB | 50.00 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 50.00 | Ω |
| 17 | RE | 0.500 | Ω |
| 18 | RC | 1.309 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | — |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | — |
| 22 | CJE | 1.071 | pF |
| 23 | VJE | 727.3 | mV |
| 24 | MJE | 0.332 | — |
| 25 | TF | 92.98 | ps |
| 26 | XTF | 43.89 | — |
| 27 | VTF | 1.813 | V |
| 28 | ITF | 143.9 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 1.167 | pF |
| 31 | VJC | 489.0 | mV |
| 32 | MJC | 0.253 | — |
| 33 | XCJC | 0.150 | — |
| 34 | TR | 50.00 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | — |
| 38 | FC | 0.950 | — |

Note

1. These parameters have not been extracted, the default values are shown.

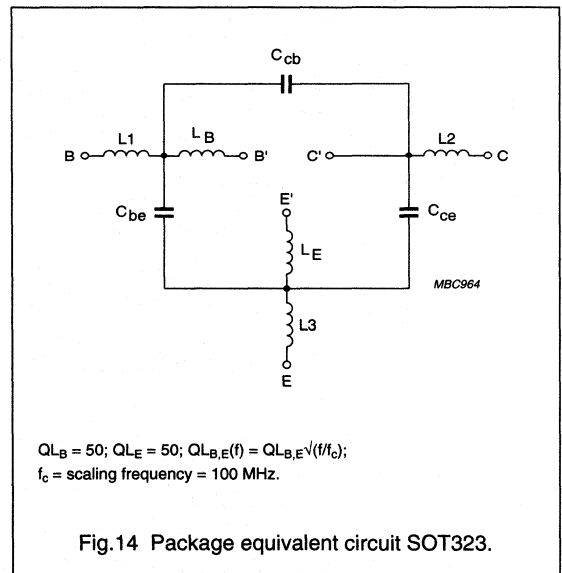


Fig.14 Package equivalent circuit SOT323.

List of components (see Fig.14).

| DESIGNATION | VALUE | UNIT |
|-----------------|-------|------|
| C _{be} | 2 | fF |
| C _{cb} | 100 | fF |
| C _{ce} | 100 | fF |
| L1 | 0.34 | nH |
| L2 | 0.10 | nH |
| L3 | 0.34 | nH |
| L _B | 0.60 | nH |
| L _E | 0.60 | nH |

NPN 2 GHz wideband transistor

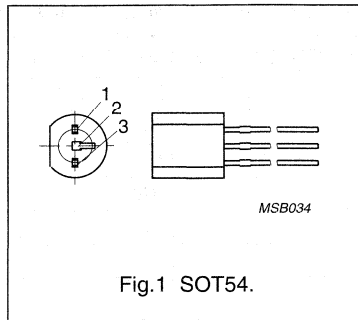
BF689K

DESCRIPTION

NPN transistor in a plastic SOT54 (TO-92 variant) envelope. It is intended for application as an amplifier or oscillator in the VHF and UHF range.

PINNING

| PIN | DESCRIPTION |
|-------------|-------------|
| Code: F689K | |
| 1 | emitter |
| 2 | base |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | DC collector current | | – | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_{amb} = 60\text{ °C}$ | – | – | 360 | mW |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; T_j = 25\text{ °C}$ | 20 | – | – | |
| | | $I_C = 20\text{ mA}; V_{CE} = 5\text{ V}; T_j = 25\text{ °C}$ | 35 | – | – | |
| f_T | transition frequency | $I_C = 15\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}$ | – | 1.8 | – | GHz |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{CER} | collector-emitter voltage | $R_{BE} \leq 50\ \Omega$ | – | 25 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3.5 | V |
| I_C | DC collector current | | – | 25 | mA |
| I_{CM} | peak collector current | $t_p < 1\ \mu s$ | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_{amb} = 60\text{ °C}$ | – | 360 | mW |
| T_{stg} | storage temperature | | –55 | 150 | °C |
| T_j | junction temperature | | – | 150 | °C |

NPN 2 GHz wideband transistor

BF689K

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|-------------|--------------------|
| $R_{th\ j-a}$ | thermal resistance from junction to ambient | in free air | 250 K/W |

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|--------------------------------------|--|------|------|------|---------------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 15\text{ V}$ | – | – | 50 | nA |
| I_{EBO} | emitter cut-off current | $I_C = 0; V_{EB} = 2\text{ V}$ | – | – | 1 | μA |
| $V_{CE\ sat}$ | collector-emitter saturation voltage | $I_C = 25\text{ mA}; I_B = 1.25\text{ mA}$ | – | – | 1.0 | V |
| $V_{BE\ sat}$ | base-emitter saturation voltage | $I_C = 25\text{ mA}; I_B = 1.25\text{ mA}$ | – | – | 1.0 | V |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}$ | 20 | – | – | |
| | | $I_C = 20\text{ mA}; V_{CE} = 5\text{ V}$ | 35 | – | – | |
| f_T | transition frequency | $I_C = 15\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}$ | – | 1.8 | – | GHz |
| C_{re} | feedback capacitance | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 1\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1.1 | – | pF |
| G_p | power gain | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 100\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}; Z_S = 60\ \Omega; R_L = 2\text{ k}\Omega$ | – | 16 | – | dB |
| | | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 200\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}; Z_S = 60\ \Omega; R_L = 920\ \Omega$ | – | 16 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 100\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}; Z_S = 60\ \Omega$ | – | 4 | – | dB |
| | | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 200\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}; Z_S = 60\ \Omega$ | – | 3 | – | dB |

NPN 1 GHz wideband transistor

BF747

FEATURES

- Stable oscillator operation
- High current gain
- Good thermal stability.

APPLICATIONS

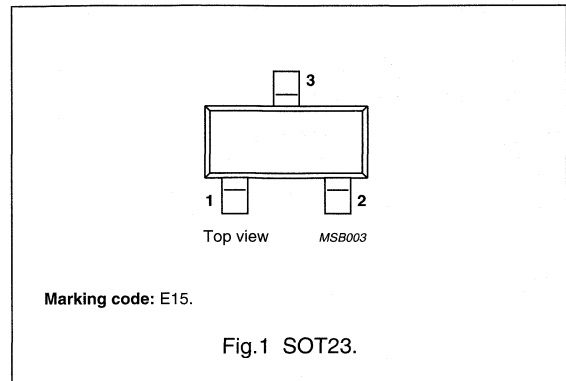
- It is intended for VHF and UHF TV-tuner applications and can be used as a mixer and/or oscillator.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |

DESCRIPTION

Low cost NPN transistor in a plastic SOT23 package.



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | – | 20 | V |
| V_{CB0} | collector-base voltage | open emitter | – | 30 | V |
| V_{EB0} | emitter-base voltage | open collector | – | 3 | V |
| I_{CM} | peak collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$ | 1.2 | 1.6 | GHz |

Note

1. T_s is the temperature at the soldering point of the collector pin.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|---|------|------|------------------|
| V_{CE0} | collector-emitter voltage | open base | – | 20 | V |
| V_{CB0} | collector-base voltage | open emitter | – | 30 | V |
| V_{EB0} | emitter-base voltage | open collector | – | 3 | V |
| I_{CM} | peak collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –55 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 150 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 1 GHz wideband transistor

BF747

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|-------------|---|---|-------|------|
| R_{thj-s} | thermal resistance from junction to soldering point | up to $T_s = 70\text{ }^\circ\text{C}$; note 1 | 260 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

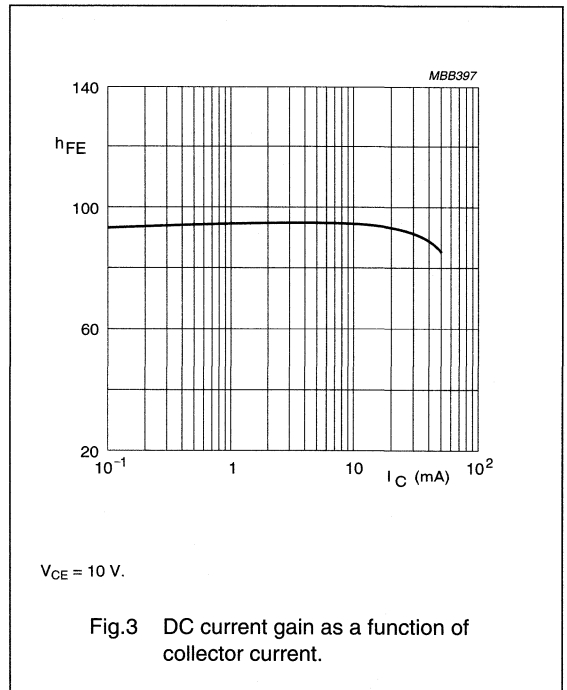
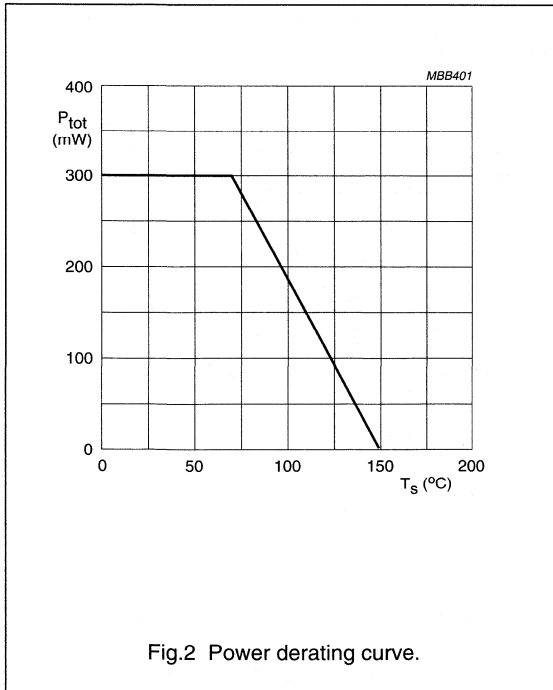
CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------------------|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 10\text{ V}$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}; V_{CE} = 10\text{ V}$ | 40 | 95 | 250 | |
| f_T | transition frequency | $I_C = 15\text{ mA}; V_{CE} = 10\text{ V}; f = 500\text{ MHz}$ | 0.8 | 1.2 | 1.6 | GHz |
| C_{re} | feedback capacitance | $I_E = I_B = 0; V_{CB} = 10\text{ V}; f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 15\text{ mA}; V_{CE} = 10\text{ V}; f = 100\text{ MHz}$ | – | 20 | – | dB |

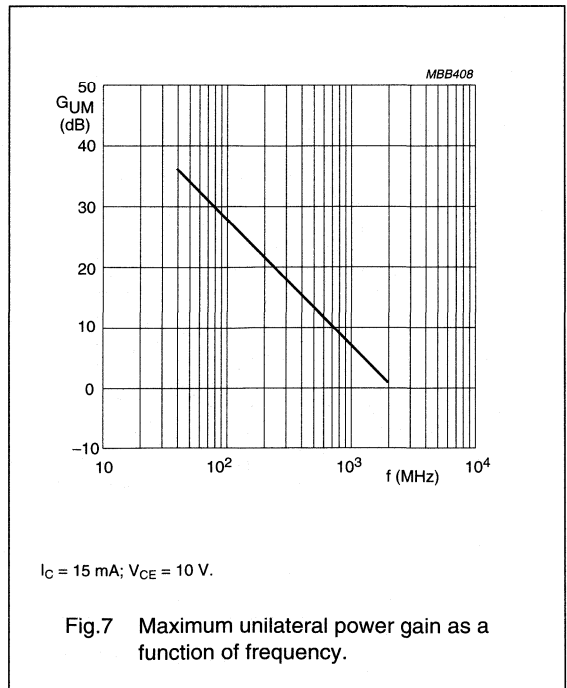
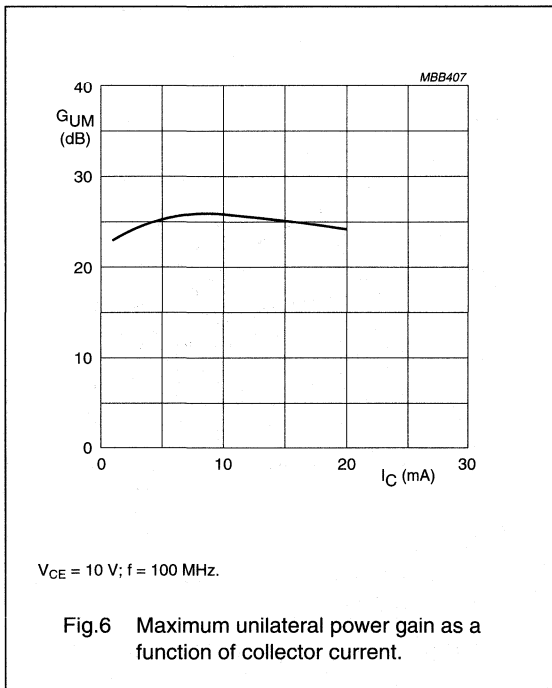
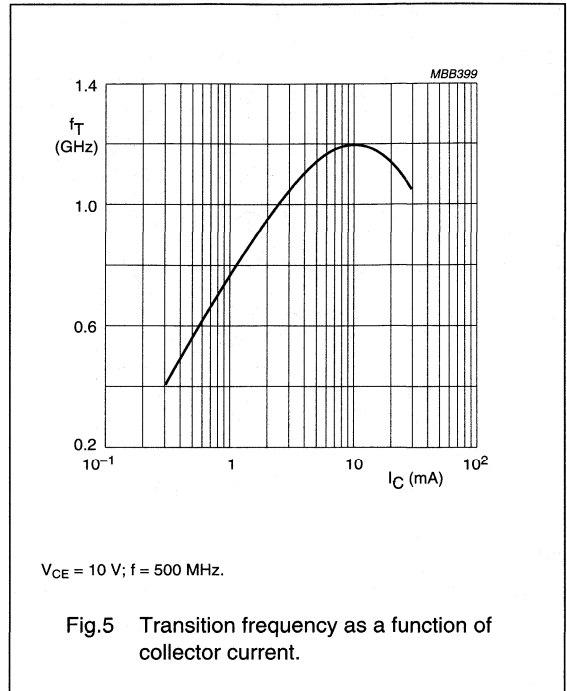
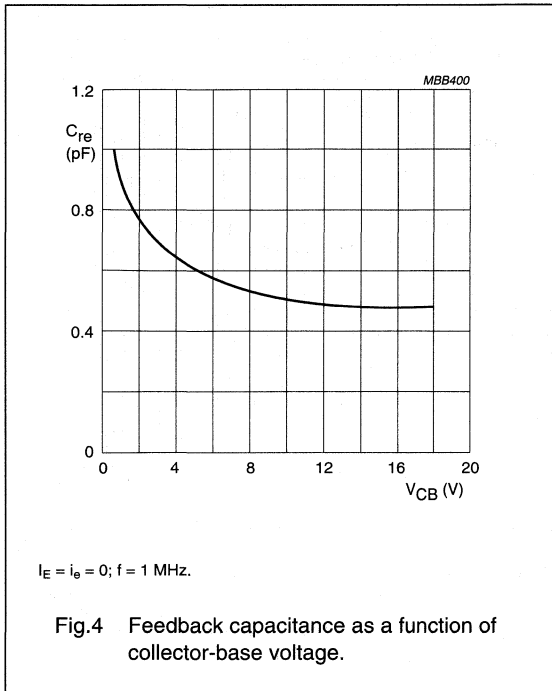
Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB .



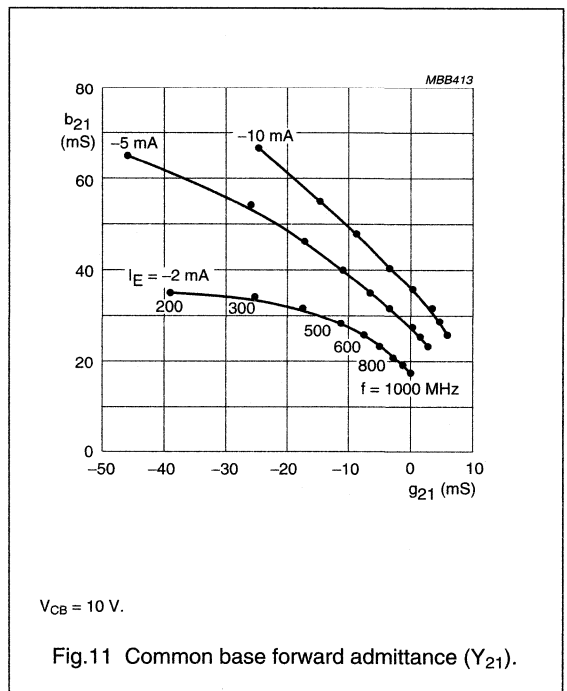
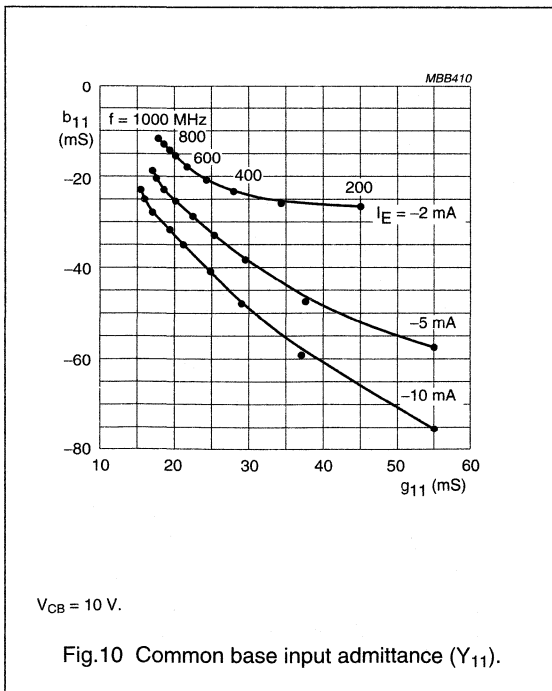
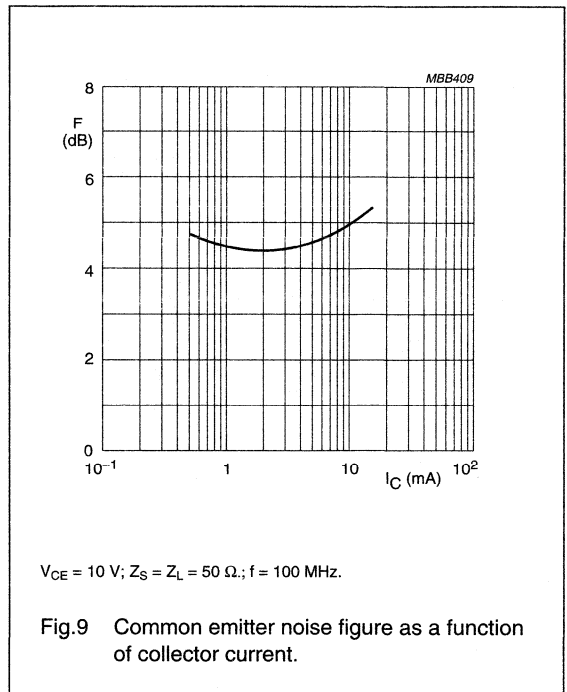
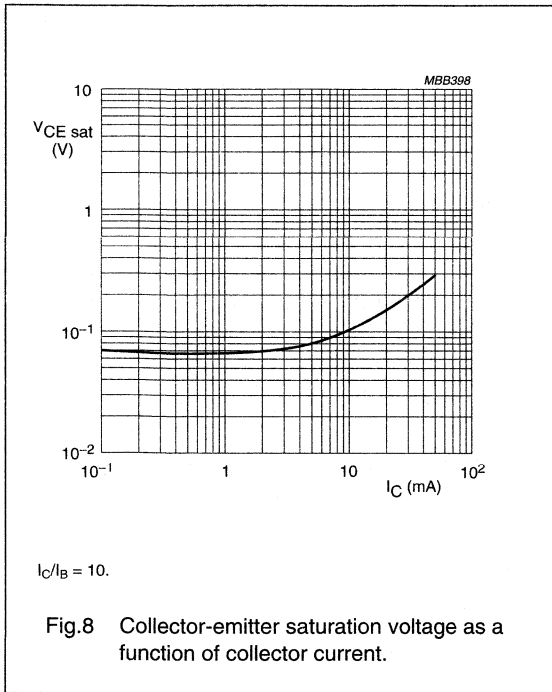
NPN 1 GHz wideband transistor

BF747



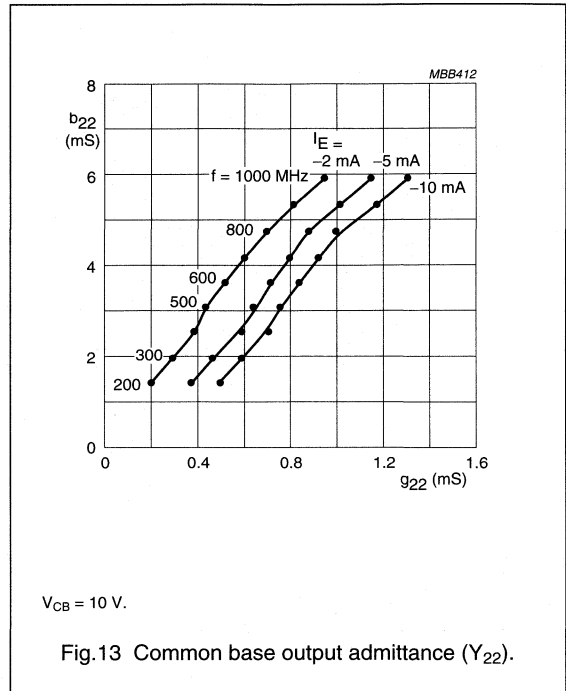
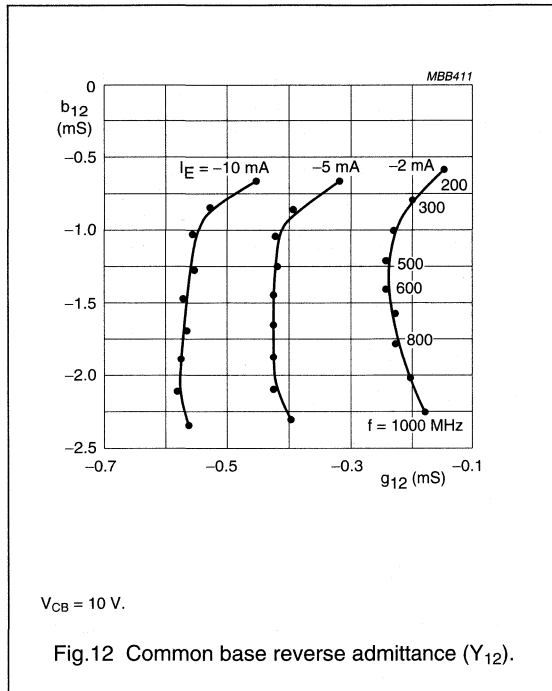
NPN 1 GHz wideband transistor

BF747



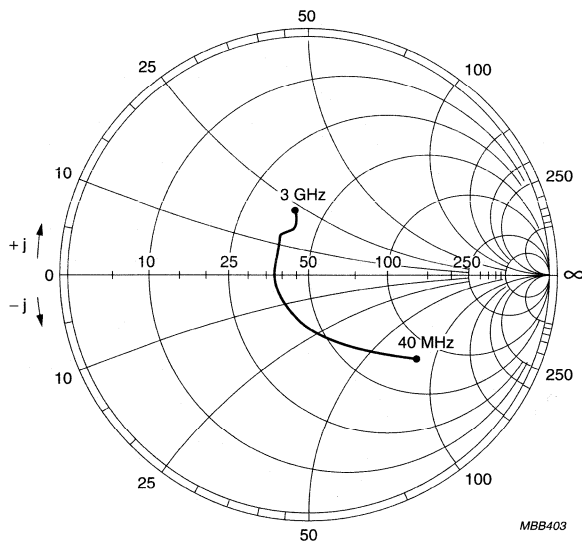
NPN 1 GHz wideband transistor

BF747



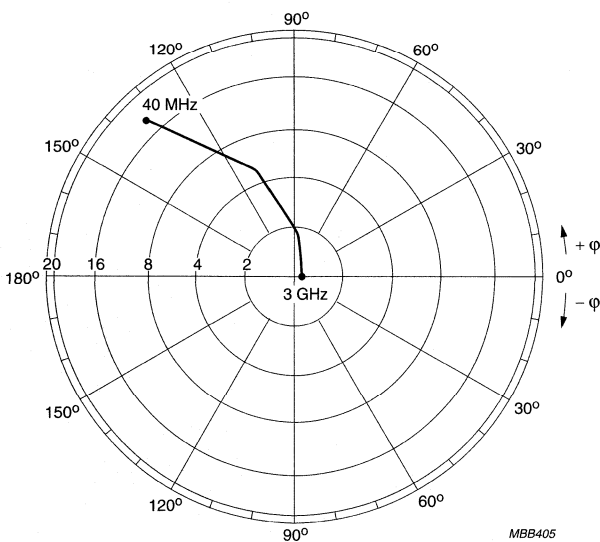
NPN 1 GHz wideband transistor

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$I_C = 15 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $Z_O = 50 \Omega$.

Fig.14 Common emitter input reflection coefficient (S_{11}).

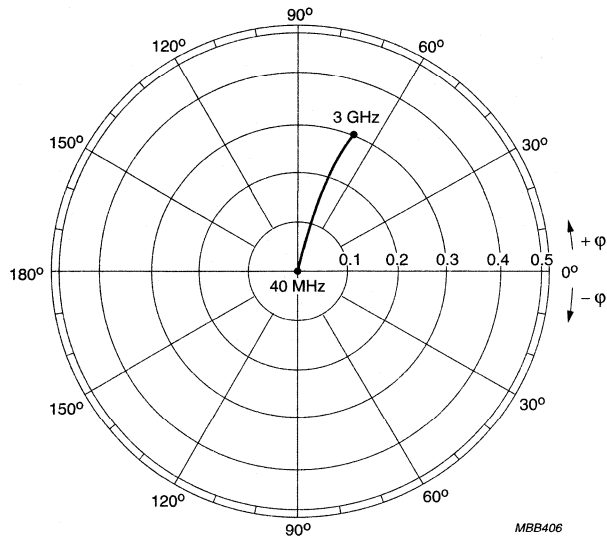


$I_C = 15 \text{ mA}$; $V_{CE} = 10 \text{ V}$.

Fig.15 Common emitter forward transmission coefficient (S_{21}).

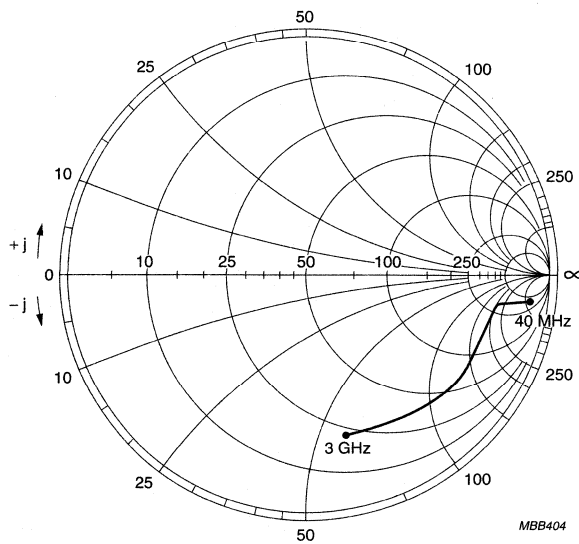
NPN 1 GHz wideband transistor

BF747



$I_C = 15 \text{ mA}; V_{CE} = 10 \text{ V}.$

Fig.16 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 15 \text{ mA}; V_{CE} = 10 \text{ V}; Z_O = 50 \Omega.$

Fig.17 Common emitter output reflection coefficient (S_{22}).

NPN 1 GHz wideband transistor

BF747

Table 1 Common base Y-parameters, $I_E = -2$ mA; $V_{CB} = 10$ V, typical values.

| f (MHz) | Y ₁₁ | | Y ₂₁ | | Y ₁₂ | | Y ₂₂ | |
|---------|-----------------|------------|-----------------|------------|-----------------|------------|-----------------|------------|
| | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) |
| 40 | 69.0 | -10.2 | -68.0 | 12.3 | -0.02 | -0.1 | -0.01 | 0.3 |
| 100 | 60.4 | -20.6 | -58.0 | 25.6 | -0.06 | -0.3 | -0.08 | 0.7 |
| 200 | 45.0 | -27.4 | -39.1 | 34.5 | -0.10 | -0.6 | 0.19 | 1.4 |
| 300 | 34.3 | -26.4 | -25.4 | 34.0 | -0.20 | -0.8 | 0.29 | 1.9 |
| 400 | 27.7 | -23.3 | -17.2 | 31.1 | -0.20 | -1.0 | 0.37 | 2.5 |
| 500 | 24.0 | -20.4 | -11.7 | 27.6 | -0.20 | -1.2 | 0.45 | 3.0 |
| 600 | 21.5 | -18.0 | -7.8 | 25.0 | -0.20 | -1.4 | 0.53 | 3.6 |
| 700 | 20.0 | -15.6 | -5.3 | 22.6 | -0.20 | -1.6 | 0.60 | 4.2 |
| 800 | 18.6 | -14.0 | -3.0 | 20.2 | -0.20 | -1.8 | 0.69 | 4.7 |
| 900 | 18.3 | -12.8 | -1.3 | 18.7 | -0.20 | -2.0 | 0.82 | 5.3 |
| 1000 | 17.8 | -11.7 | -0.1 | 17.1 | -0.20 | -2.2 | 0.95 | 5.9 |

Table 2 Common base Y-parameters, $I_E = -5$ mA; $V_{CB} = 10$ V, typical values.

| f (MHz) | Y ₁₁ | | Y ₂₁ | | Y ₁₂ | | Y ₂₂ | |
|---------|-----------------|------------|-----------------|------------|-----------------|------------|-----------------|------------|
| | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) |
| 40 | 132.6 | -35.7 | -130.5 | 38.8 | -0.06 | -0.2 | -0.06 | 0.4 |
| 100 | 96.3 | -62.0 | -91.1 | 67.9 | -0.20 | -0.5 | 0.21 | 0.8 |
| 200 | 54.7 | -57.8 | -46.0 | 64.7 | -0.30 | -0.7 | 0.38 | 1.4 |
| 300 | 37.5 | -46.9 | -26.4 | 53.8 | -0.40 | -0.8 | 0.47 | 2.0 |
| 400 | 29.2 | -38.6 | -16.6 | 45.8 | -0.40 | -1.0 | 0.58 | 2.5 |
| 500 | 25.3 | -32.8 | -11.0 | 39.8 | -0.40 | -1.3 | 0.63 | 3.1 |
| 600 | 22.0 | -28.4 | -6.3 | 35.0 | -0.40 | -1.4 | 0.71 | 3.6 |
| 700 | 20.3 | -25.2 | -3.3 | 31.4 | -0.40 | -1.6 | 0.80 | 4.2 |
| 800 | 18.7 | -22.6 | -0.6 | 27.6 | -0.40 | -1.9 | 0.88 | 4.7 |
| 900 | 17.8 | -20.7 | 1.4 | 25.2 | -0.40 | -2.1 | 1.01 | 5.3 |
| 1000 | 17.3 | -19.1 | 3.0 | 23.0 | -0.40 | -2.3 | 1.15 | 6.0 |

NPN 1 GHz wideband transistor

BF747

Table 3 Common base Y-parameters, $I_E = -10$ mA; $V_{CB} = 10$ V, typical values.

| f (MHz) | Y ₁₁ | | Y ₂₁ | | Y ₁₂ | | Y ₂₂ | |
|---------|-----------------|------------|-----------------|------------|-----------------|------------|-----------------|------------|
| | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) |
| 40 | 189.0 | -79.6 | -185.5 | 83.0 | -0.10 | -0.3 | -0.09 | 0.4 |
| 100 | 108.5 | -99.0 | -101.4 | 105.4 | -0.30 | -0.5 | 0.30 | 0.9 |
| 200 | 55.2 | -76.2 | -44.6 | 82.8 | -0.50 | -0.7 | 0.44 | 1.4 |
| 300 | 37.1 | -59.0 | -24.3 | 65.7 | -0.50 | -0.9 | 0.60 | 2.0 |
| 400 | 28.8 | -47.6 | -14.6 | 54.4 | -0.60 | -1.0 | 0.69 | 2.5 |
| 500 | 24.7 | -40.2 | -8.6 | 46.7 | -0.60 | -1.3 | 0.75 | 3.1 |
| 600 | 21.2 | -35.0 | -3.4 | 40.8 | -0.60 | -1.5 | 0.84 | 3.6 |
| 700 | 19.3 | -31.0 | -0.2 | 36.2 | -0.60 | -1.7 | 0.93 | 4.2 |
| 800 | 17.2 | -27.5 | 2.6 | 31.1 | -0.60 | -1.9 | 1.00 | 4.7 |
| 900 | 16.4 | -25.2 | 4.6 | 28.3 | -0.60 | -2.1 | 1.15 | 5.3 |
| 1000 | 15.8 | -23.0 | 6.0 | 25.5 | -0.60 | -2.3 | 1.31 | 6.0 |

Table 4 Common base Y-parameters, $I_E = -15$ mA; $V_{CB} = 10$ V, typical values.

| f (MHz) | Y ₁₁ | | Y ₂₁ | | Y ₁₂ | | Y ₂₂ | |
|---------|-----------------|------------|-----------------|------------|-----------------|------------|-----------------|------------|
| | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) | REAL (mS) | IMAG. (mS) |
| 40 | 206.5 | -113.8 | -202.6 | 118.1 | -0.20 | -0.3 | 0.2 | 0.5 |
| 100 | 104.3 | -114.0 | -96.4 | 120.1 | -0.40 | -0.5 | 0.4 | 0.9 |
| 200 | 53.1 | -81.1 | -41.7 | 87.7 | -0.50 | -0.7 | 0.6 | 1.4 |
| 300 | 35.9 | -62.1 | -22.0 | 68.6 | -0.60 | -0.8 | 0.7 | 2.0 |
| 400 | 28.1 | -50.0 | -12.5 | 56.9 | -0.60 | -1.1 | 0.8 | 2.5 |
| 500 | 23.4 | -42.3 | -6.1 | 48.2 | -0.60 | -1.3 | 0.8 | 3.1 |
| 600 | 20.1 | -36.4 | -1.2 | 41.6 | -0.60 | -1.5 | 0.9 | 3.6 |
| 700 | 18.2 | -32.0 | 2.0 | 36.7 | -0.60 | -1.7 | 1.0 | 4.2 |
| 800 | 16.2 | -28.2 | 4.5 | 31.3 | -0.60 | -1.9 | 1.1 | 4.7 |
| 900 | 15.5 | -25.7 | 6.5 | 28.1 | -0.60 | -2.1 | 1.3 | 5.3 |
| 1000 | 14.7 | -23.5 | 7.9 | 24.9 | -0.60 | -2.3 | 1.4 | 5.9 |

NPN 2 GHz wideband transistor

BF763

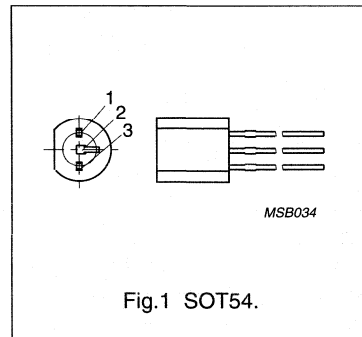
DESCRIPTION

NPN transistor in a plastic SOT54 (TO-92 variant) envelope.

It is primarily intended for use in RF amplifiers and oscillators.

PINNING

| PIN | DESCRIPTION |
|------------|-------------|
| Code: F763 | |
| 1 | emitter |
| 2 | base |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|-------------------------------------|---|------|------|------|------|
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base | 15 | – | – | V |
| I_C | DC collector current | | – | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_{amb} = 60\text{ °C}$ | – | – | 360 | mW |
| h_{FE} | DC current gain | $I_C = 5\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_j = 25\text{ °C}$ | 25 | – | 250 | |
| f_T | transition frequency | $I_C = 5\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 100\text{ MHz}$ | – | 1.8 | – | GHz |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| I_C | DC collector current | | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_{amb} = 60\text{ °C}$ | – | 360 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 150 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|-------------|--------------------|
| $R_{th\ j-a}$ | thermal resistance from junction to ambient | in free air | 250 K/W |

NPN 2 GHz wideband transistor

BF763

CHARACTERISTICS $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------------|--------------------------------------|--|------|------|------|------|
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 1\text{ mA}; I_B = 0$ | 15 | – | – | V |
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 10\text{ }\mu\text{A}; I_E = 0$ | 25 | – | – | V |
| $V_{CE\text{ sat}}$ | collector-emitter saturation voltage | $I_C = 10\text{ mA}; I_B = 1\text{ mA}$ | – | – | 0.5 | V |
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 10\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 5\text{ mA}; V_{CE} = 10\text{ V}$ | 25 | – | 250 | |
| f_T | transition frequency | $I_C = 5\text{ mA}; V_{CE} = 10\text{ V}; f = 100\text{ MHz}$ | – | 1.8 | – | GHz |
| F | noise figure | $I_C = 5\text{ mA}; V_{CE} = 10\text{ V}; f = 800\text{ MHz};$ $T_{amb} = 25\text{ }^\circ\text{C}; Z_s = 60\text{ }\Omega$ | – | 5.0 | – | dB |

NPN wideband cascode transistor

BFC505

FEATURES

- Small size
- High power gain at low bias current and high frequencies
- High reverse isolation
- Low noise figure
- Gold metallization ensures excellent reliability
- Minimum operating voltage $V_{C2-E1} = 1$ V.

APPLICATIONS

- Low voltage, low current, low noise and high gain amplifiers
- Oscillator buffer amplifiers
- Wideband voltage-to-current converters.

DESCRIPTION

Cascode amplifier with two discrete dies in a surface mount, 5-pin SOT353 (S-mini) package. The amplifier is primarily intended for low power RF communications equipment, such as pagers and has a very low feedback capacitance resulting in high isolation.

PINNING - SOT353

| PIN | SYMBOL | DESCRIPTION |
|-----|--------------------------------|-----------------------|
| 1 | b ₂ | base 2 |
| 2 | e ₁ | emitter 1 |
| 3 | b ₁ | base 1 |
| 4 | c ₁ /e ₂ | collector 1/emitter 2 |
| 5 | c ₂ | collector 2 |

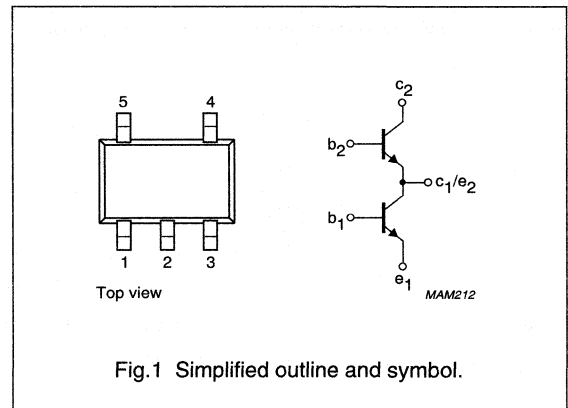


Fig.1 Simplified outline and symbol.

QUICK REFERENCE DATA

b₂ connected to ground via 1 nF (0603) capacitor, e₁ connected directly to ground.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---|---|--|------|------|------|------|
| C _{re} | feedback capacitance C _{B1-C2} | I _e = 0; V _{C2-E1} = 0; f = 1 MHz | – | – | 10 | fF |
| s ₂₁ /s ₁₂ ² | maximum isolation | I _C = 5 mA; V _{C2} = V _{B2} = 3 V; f = 900 MHz | 60 | – | – | dB |
| MSG | maximum stable power gain | I _C = 0.5 mA; V _{C2} = V _{B2} = 1 V; f = 900 MHz; T _{amb} = 25 °C | – | 22 | – | dB |
| F | noise figure | I _C = 0.5 mA; V _{C2-E1} = 1 V; f = 500 MHz; Γ _S = Γ _{opt} | – | 1.1 | 1.4 | dB |
| | | I _C = 1 mA; V _{C2-E1} = 3 V; f = 900 MHz; Γ _S = Γ _{opt} | – | 1.8 | 2.1 | dB |
| R _{th j-s} | thermal resistance from junction to soldering point | single loaded | – | – | 230 | K/W |
| | | double loaded | – | – | 115 | K/W |

NPN wideband cascode transistor

BFC505

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------------------|---------------------------|--------------------------------------|------|------|------|
| Any single transistor | | | | | |
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ °C}$; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | +175 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point; note 1 | single loaded | 230 | K/W |
| | | double loaded | 115 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.

NPN wideband cascode transistor

BFC505

CHARACTERISTICS

 $T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--|-------------------------------------|---|------|------|------|------|
| DC characteristics of any single transistor | | | | | | |
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\ \mu\text{A}; I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 10\ \mu\text{A}; I_B = 0$ | 8 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 2.5\ \mu\text{A}; I_C = 0$ | 2.5 | – | – | V |
| I_{CBO} | collector-base leakage current | $I_E = 0; V_{CB} = 6\ \text{V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 5\ \text{mA}; V_{CE} = 6\ \text{V}$ | 60 | 120 | 250 | |
| AC characteristics of the cascode configuration measured in test circuit (note 1) | | | | | | |
| f_T | transition frequency | $I_C = 5\ \text{mA}; V_{C2-E1} = 3\ \text{V}; f = 1\ \text{GHz}$ | – | 7.3 | – | GHz |
| C_c | collector capacitance T2 | $I_E = I_e = 0; V_{C2-B2} = 0; f = 1\ \text{MHz}$ | – | 0.4 | – | pF |
| C_{re2} | feedback capacitance T2 | $I_C = 0; V_{C2-E1} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | 250 | – | fF |
| C_{re} | feedback capacitance | $I_C = 0; V_{C2-E1} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | – | 10 | fF |
| MSG | maximum stable power gain; note 2 | $I_C = 0.25\ \text{mA}; V_{C2-E1} = 1\ \text{V}; f = 300\ \text{MHz}; T_{amb} = 25\text{ °C}$ | – | 25 | – | dB |
| | | $I_C = 0.5\ \text{mA}; V_{C2-E1} = 1\ \text{V}; f = 900\ \text{MHz}; T_{amb} = 25\text{ °C}$ | – | 22 | – | dB |
| | | $I_C = 5\ \text{mA}; V_{C2-E1} = 3\ \text{V}; f = 2\ \text{GHz}; T_{amb} = 25\text{ °C}$ | – | 23 | – | dB |
| $ s_{21} ^2$ | insertion power gain | $I_C = 0.5\ \text{mA}; V_{C2-E1} = 3\ \text{V}; f = 300\ \text{MHz}; T_{amb} = 25\text{ °C}$ | – | 21 | – | dB |
| | | $I_C = 5\ \text{mA}; V_{C2-E1} = 3\ \text{V}; f = 900\ \text{MHz}; T_{amb} = 25\text{ °C}$ | – | 16 | – | dB |
| | | $I_C = 5\ \text{mA}; V_{C2-E1} = 3\ \text{V}; f = 2\ \text{GHz}; T_{amb} = 25\text{ °C}$ | – | 11 | – | dB |
| $ s_{21}/s_{12} ^2$ | maximum isolation; note 3 | $I_C = 0.5\ \text{mA}; V_{C2-E1} = 1\ \text{V}; f = 900\ \text{MHz}$ | 40 | 45 | – | dB |
| | | $I_C = 5\ \text{mA}; V_{C2-E1} = 3\ \text{V}; f = 900\ \text{MHz}$ | 60 | 68 | – | dB |
| | | $I_C = 5\ \text{mA}; V_{C2-E1} = 3\ \text{V}; f = 2\ \text{GHz}$ | 40 | 48 | – | dB |
| F | noise figure | $I_C = 0.5\ \text{mA}; V_{C2-E1} = 1\ \text{V}; f = 500\ \text{MHz}; \Gamma_S = \Gamma_{opt}$ | – | 1.1 | 1.4 | dB |
| | | $I_C = 1\ \text{mA}; V_{C2-E1} = 3\ \text{V}; f = 900\ \text{MHz}; \Gamma_S = \Gamma_{opt}$ | – | 1.8 | 2.1 | dB |
| | | $I_C = 1\ \text{mA}; V_{C2-E1} = 1\ \text{V}; f = 2\ \text{GHz}; \Gamma_S = \Gamma_{opt}$ | – | 3.5 | – | dB |
| IP_3 | third order intercept point (input) | note 4 | – | –20 | – | dBm |

NPN wideband cascode transistor

BFC505

Notes

1. $V_{B2} = V_{C2-E1}/2 + 0.6 \text{ V}$
2. $MSG = |s_{12}/s_{21}| \times (k - \sqrt{k^2 - 1})$; $k = \frac{1 + |s_{11} \times s_{22} - s_{12} \times s_{21}|^2 - (|s_{11}|^2 - |s_{22}|^2)}{2 \times |s_{12} \times s_{21}|}$
3. Maximum isolation is defined as the isolation when S_{21} of the amplifier is reduced to unity (buffer application).
4. $I_C = 1 \text{ mA}$; $V_{CE} = 3 \text{ V}$; $R_S = 50 \Omega$; $Z_L = \text{opt}$; $T_{\text{amb}} = 25 \text{ }^\circ\text{C}$; $f_p = 900 \text{ MHz}$; $f_q = 902 \text{ MHz}$; measured at $f_{(2p-q)} = 904 \text{ MHz}$.

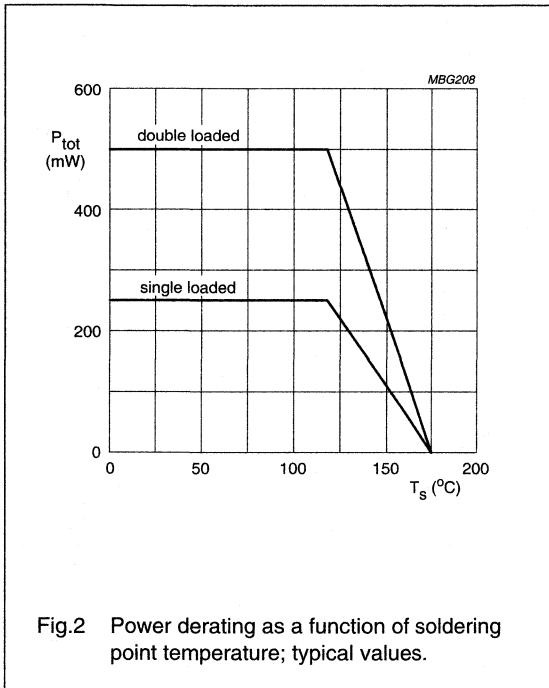
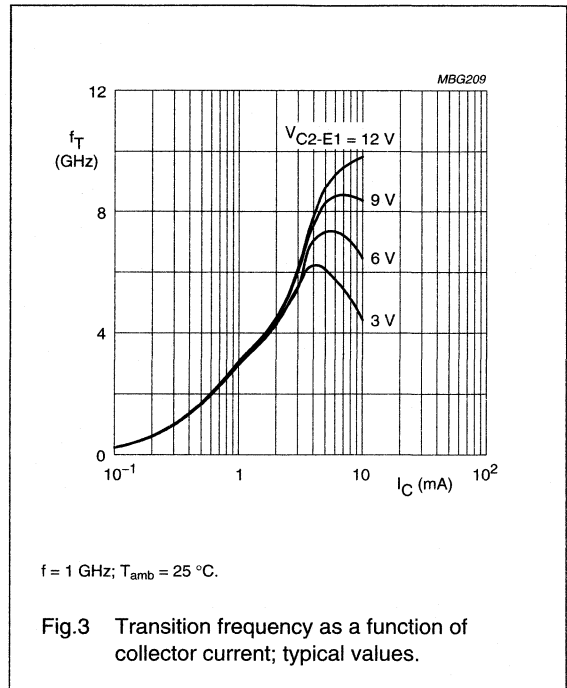


Fig.2 Power derating as a function of soldering point temperature; typical values.

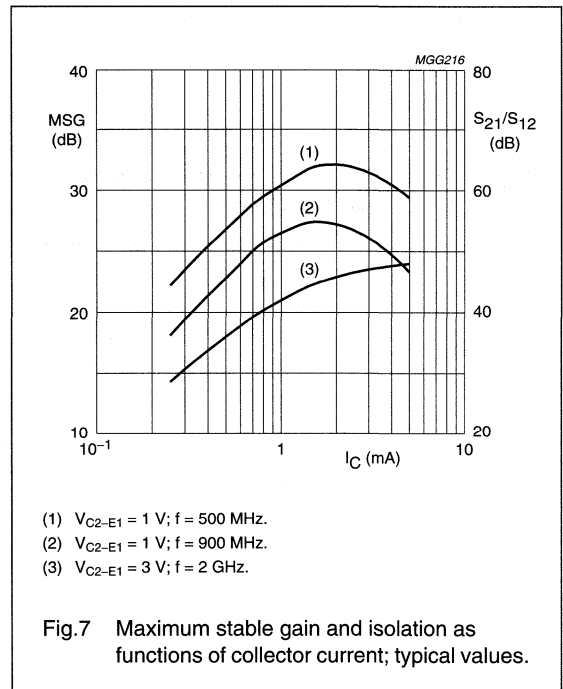
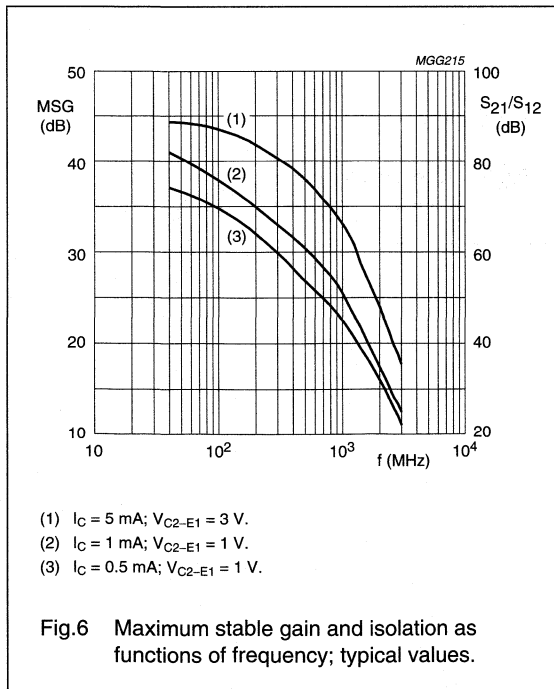
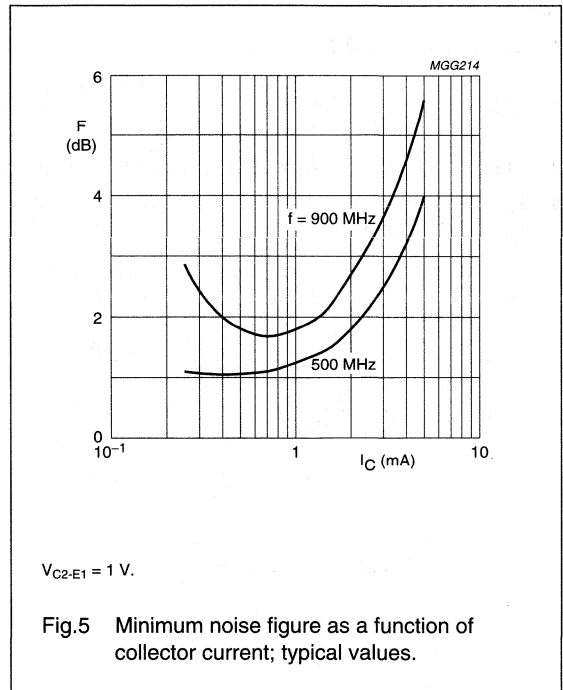
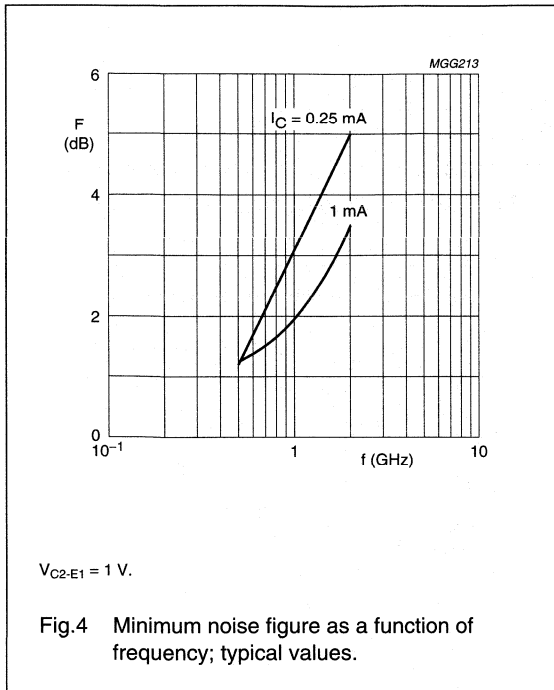


$f = 1 \text{ GHz}$; $T_{\text{amb}} = 25 \text{ }^\circ\text{C}$.

Fig.3 Transition frequency as a function of collector current; typical values.

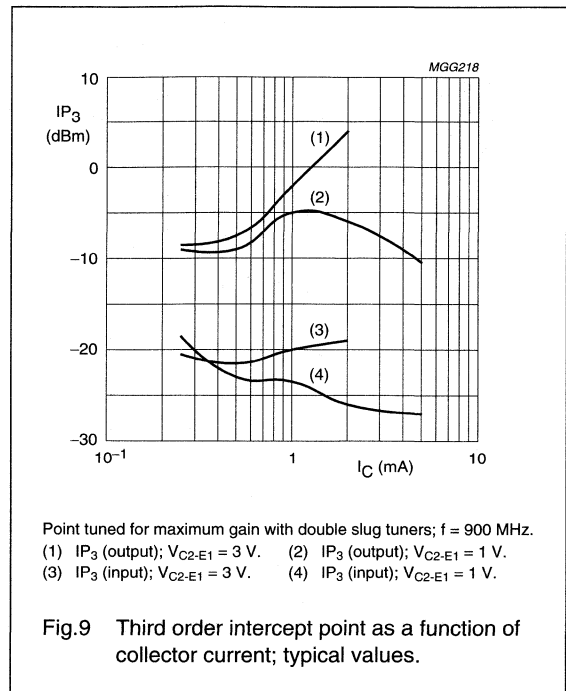
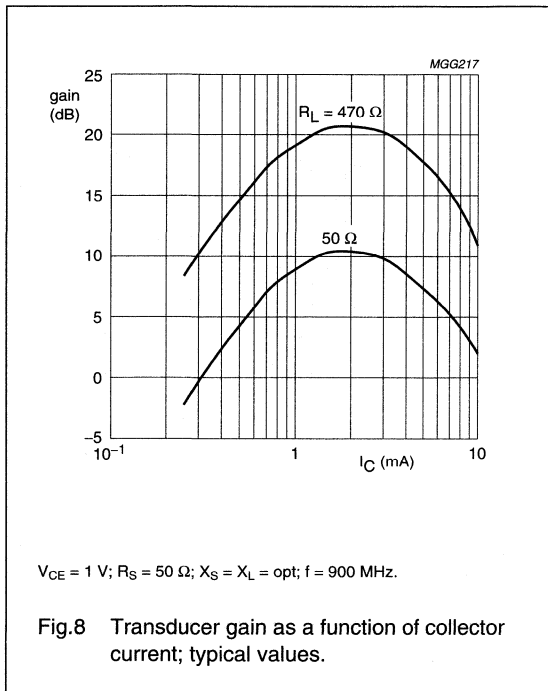
NPN wideband cascode transistor

BFC505



NPN wideband cascode transistor

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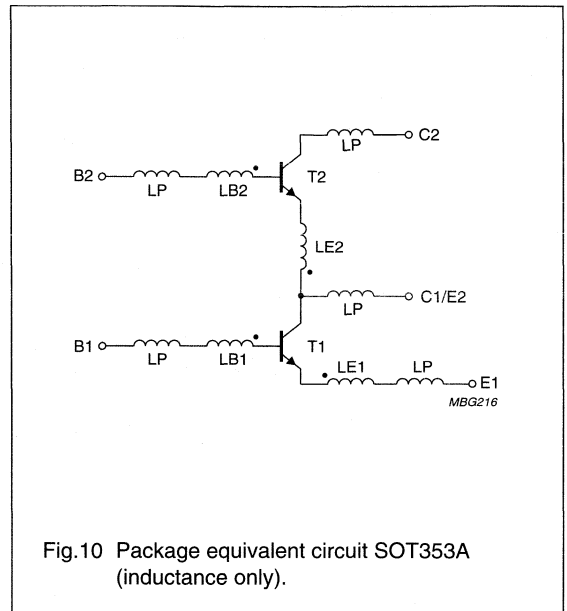
APPLICATION INFORMATION

SPICE parameters for any single BFC505 die

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|----------|
| 1 | IS | 134.1 | aA |
| 2 | BF | 180.0 | — |
| 3 | NF | 0.988 | — |
| 4 | VAF | 38.34 | V |
| 5 | IKF | 150.0 | mA |
| 6 | ISE | 27.81 | fA |
| 7 | NE | 2.051 | — |
| 8 | BR | 55.19 | — |
| 9 | NR | 0.982 | — |
| 10 | VAR | 2.459 | V |
| 11 | IKR | 2.920 | mA |
| 12 | ISC | 17.45 | aA |
| 13 | NC | 1.062 | — |
| 14 | RB | 20.00 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 20.00 | Ω |
| 17 | RE | 1.171 | Ω |
| 18 | RC | 4.350 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | — |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | — |
| 22 | CJE | 284.7 | fF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.303 | — |
| 25 | TF | 7.037 | ps |
| 26 | XTF | 12.34 | — |
| 27 | VTF | 1.701 | V |
| 28 | ITF | 30.64 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 242.4 | fF |
| 31 | VJC | 188.6 | mV |
| 32 | MJC | 0.041 | — |
| 33 | XCJC | 0.130 | — |
| 34 | TR | 1.332 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | — |
| 38 | FC | 0.897 | — |

Note

- These parameters have not been extracted, the default values are shown.



Lead and mutual inductances (nH)

| | | | |
|-------|-----|------------|-------|
| LP | 0.4 | M(LB1,LE1) | +0.4 |
| LB1,2 | 0.5 | M(LB1,LE2) | +0.25 |
| LE1,2 | 0.8 | | |

| | | | | |
|-------|-----|----|----|----|
| E1 | 35 | | | |
| B2 | 3.5 | 35 | | |
| C2 | 2 | 35 | 36 | |
| C1/E2 | 36 | 35 | 2 | 15 |
| | B1 | E1 | B2 | C2 |

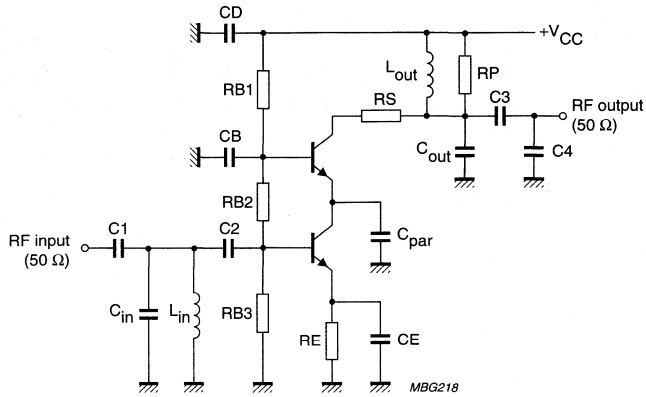
MBG217

Fig.11 Package capacitance (fF) between indicated nodes.

NPN wideband cascode transistor

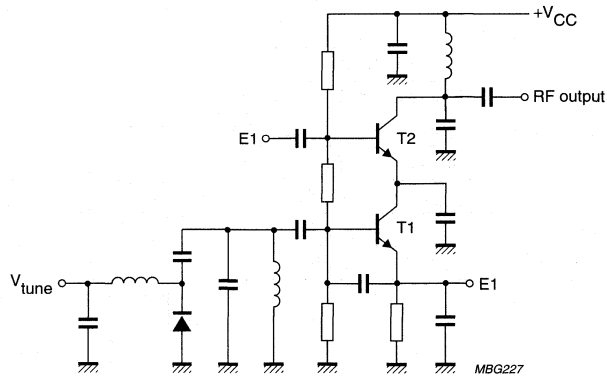
BFC505

Typical application circuits



RS increases stability.

Fig.12 Narrowband amplifier.



T1 forms a colpitts oscillator.
T2 acts as a buffer amplifier.

Fig.13 VCO/buffer combination.

NPN wideband cascode transistor

BFC520

FEATURES

- Small size
- High power gain at low bias current and high frequencies
- High reverse isolation
- Low noise figure
- Gold metallization ensures excellent reliability
- Minimum operating voltage $V_{C2-E1} = 1$ V.

APPLICATIONS

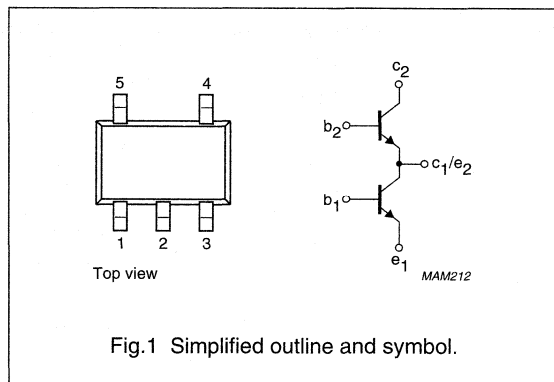
- Low noise, high gain amplifiers
- Oscillator buffer amplifiers
- Wideband voltage-to-current converters.

DESCRIPTION

Cascode amplifier with two discrete dies in a surface mount, 5-pin SOT353 (S-mini) package. The amplifier is primarily intended for low power RF communications equipment, such as pagers and cordless phones and has a very low feedback capacitance resulting in high isolation.

PINNING - SOT353

| SYMBOL | PIN | DESCRIPTION |
|-----------|-----|-----------------------|
| b_2 | 1 | base 2 |
| e_1 | 2 | emitter 1 |
| b_1 | 3 | base 1 |
| c_1/e_2 | 4 | collector 1/emitter 2 |
| c_2 | 5 | collector 2 |



QUICK REFERENCE DATA

$V_{C2-E1} = 3$ V; $I_C = 20$ mA; $V_{B2} = 2.1$ V; b_2 connected to ground via 1 nF (0603) capacitor, e_1 connected directly to ground.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------------|---|--|------|------|------|------|
| C_{re} | feedback capacitance C_{B1-C2} | | – | – | 10 | fF |
| $ s_{21}/s_{12} ^2$ | maximum isolation | $f = 900$ MHz; $T_{amb} = 25$ °C | – | –63 | – | dB |
| | | $f = 2$ GHz; $T_{amb} = 25$ °C | – | –38 | – | dB |
| MSG | maximum stable power gain (narrowband) | $f = 900$ MHz; $T_{amb} = 25$ °C | – | 31 | – | dB |
| | | $f = 2$ GHz; $T_{amb} = 25$ °C | – | 19 | – | dB |
| F | noise figure | $I_C = 5$ mA; $f = 900$ MHz; $\Gamma_S = \Gamma_{opt}$ | – | 1.3 | 1.6 | dB |
| $R_{th j-s}$ | thermal resistance from junction to soldering point | single loaded | – | – | 230 | K/W |
| | | double loaded | – | – | 115 | K/W |

NPN wideband cascode transistor

BFC520

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------------------|---------------------------|--------------------------------------|------|------|------|
| Any single transistor | | | | | |
| V _{CB0} | collector-base voltage | open emitter | – | 20 | V |
| V _{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V _{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I _C | DC collector current | | – | 70 | mA |
| P _{tot} | total power dissipation | up to T _s = 60 °C; note 1 | – | 1 | W |
| T _{stg} | storage temperature | | –65 | +175 | °C |
| T _j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------------|---|---------------|-------|------|
| R _{th j-s} | thermal resistance from junction to soldering point; note 1 | single loaded | 230 | K/W |
| | | double loaded | 115 | K/W |

Note to the Limiting values and Thermal characteristics

1. T_s is the temperature at the soldering point of the collector pin.

NPN wideband cascode transistor

BFC520

CHARACTERISTICS

 $T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--|-------------------------------------|--|------|------|------|------|
| DC characteristics of any single transistor | | | | | | |
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\ \mu\text{A}; I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 10\ \mu\text{A}; I_B = 0$ | 8 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 2.5\ \mu\text{A}; I_C = 0$ | 2.5 | – | – | V |
| I_{CBO} | collector-base leakage current | $I_E = 0; V_{CB} = 6\ \text{V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 20\ \text{mA}; V_{CE} = 6\ \text{V}$ | 60 | 120 | 250 | |
| AC characteristics of the cascode configuration | | | | | | |
| f_T | transition frequency | $I_C = 20\ \text{mA}; V_{C2-E1} = 3\ \text{V};$ $f = 1\ \text{GHz}$ | – | 7 | – | GHz |
| C_c | collector capacitance T2 | $I_E = I_B = 0; V_{C2-B2} = 1\ \text{V};$ $f = 1\ \text{MHz}$ | – | 0.55 | – | pF |
| C_{re2} | feedback capacitance T2 | $I_C = 0; V_{C2-E1} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | 500 | – | fF |
| C_{re} | feedback capacitance | $I_C = 0; V_{C2-E1} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | – | 10 | fF |
| MSG | maximum stable power gain; note 1 | $I_C = 20\ \text{mA}; V_{C2-E1} = 3\ \text{V};$ $f = 900\ \text{MHz}; T_{amb} = 25\text{ °C}$ | – | 31 | – | dB |
| | | $I_C = 20\ \text{mA}; V_{C2-E1} = 3\ \text{V};$ $f = 2\ \text{GHz}; T_{amb} = 25\text{ °C}$ | – | 19 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 20\ \text{mA}; V_{C2-E1} = 3\ \text{V};$ $f = 900\ \text{MHz}; T_{amb} = 25\text{ °C}$ | – | 17 | – | dB |
| | | $I_C = 20\ \text{mA}; V_{C2-E1} = 3\ \text{V};$ $f = 2\ \text{GHz}; T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| $ S_{21}/S_{12} ^2$ | maximum isolation; note 2 | $f = 900\ \text{MHz}$ | – | 63 | – | dB |
| | | $f = 2\ \text{GHz}$ | – | 38 | – | dB |
| F | noise figure | $I_C = 5\ \text{mA}; V_{C2-E1} = 3\ \text{V};$ $f = 900\ \text{MHz}; \Gamma_S = \Gamma_{opt}$ | – | 1.3 | 1.6 | dB |
| IP ₃ | third order intercept point (input) | note 3 | – | –18 | – | dBm |

Notes

$$1. \text{ MSG} = |S_{12}/S_{21}| \times \left(k - \sqrt{k^2 - 1} \right) \quad k = \frac{1 + |S_{11} \times S_{22} - S_{12} \times S_{21}|^2 - (|S_{11}|^2 - |S_{22}|^2)}{2 \times |S_{12} \times S_{21}|}$$

2. Maximum isolation is defined as the isolation when S_{21} of the amplifier is reduced to unity (buffer application).

3. $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V}; R_S = 50\ \Omega; Z_L = \text{opt}; T_{amb} = 25\text{ °C};$
 $f_p = 900\ \text{MHz}; f_q = 902\ \text{MHz};$ measured at $f_{(2p-q)} = 904\ \text{MHz}.$

NPN wideband cascode transistor

BFC520

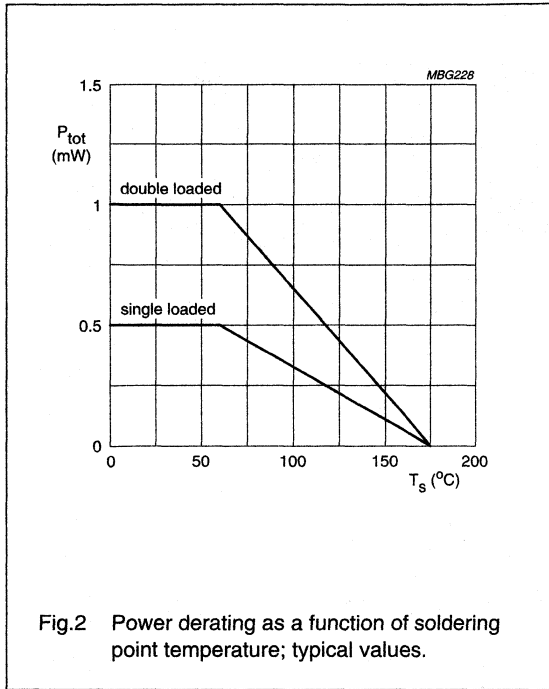
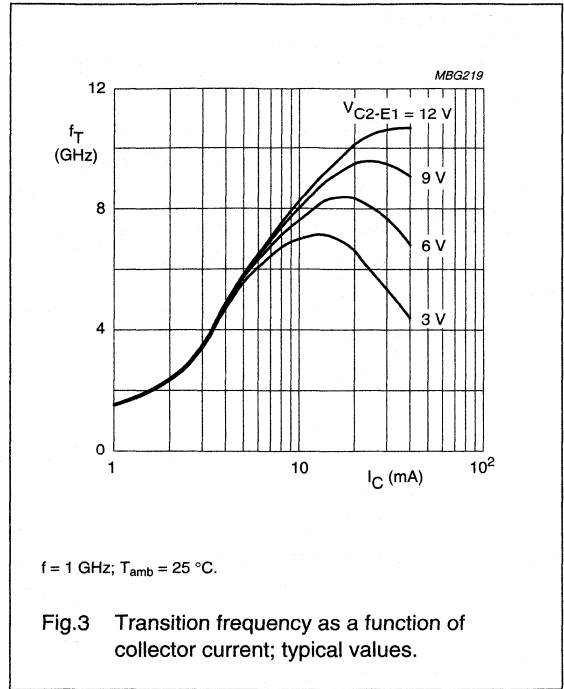
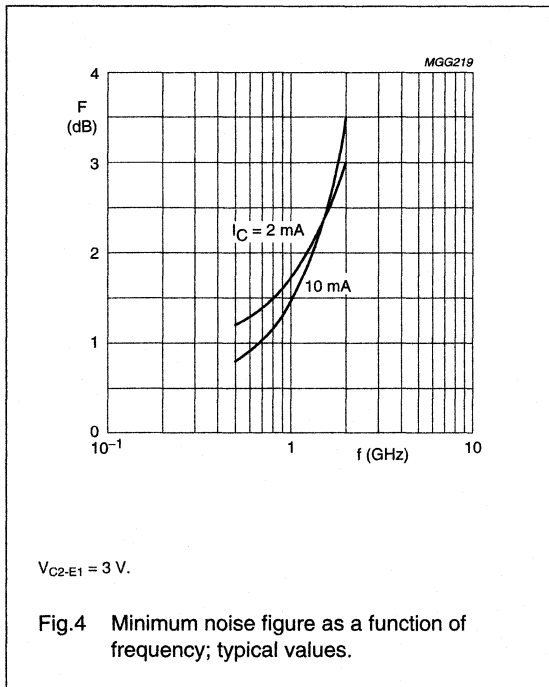


Fig.2 Power derating as a function of soldering point temperature; typical values.



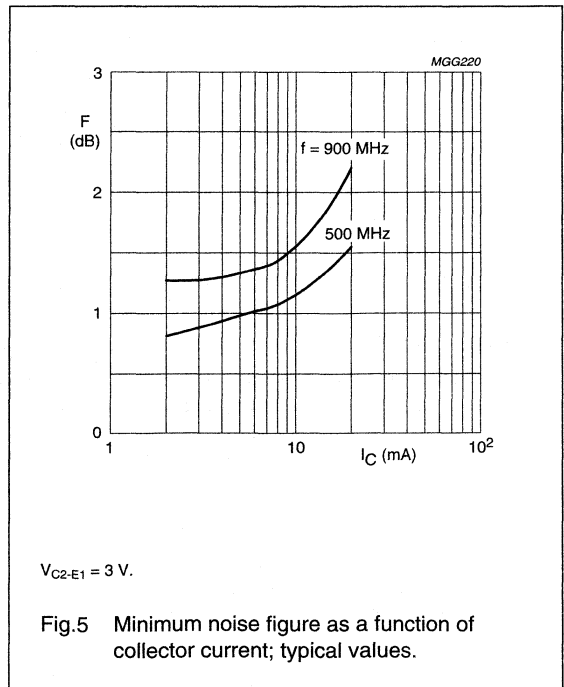
$f = 1 \text{ GHz}; T_{amb} = 25 \text{ }^\circ\text{C}.$

Fig.3 Transition frequency as a function of collector current; typical values.



$V_{C2-E1} = 3 \text{ V}.$

Fig.4 Minimum noise figure as a function of frequency; typical values.

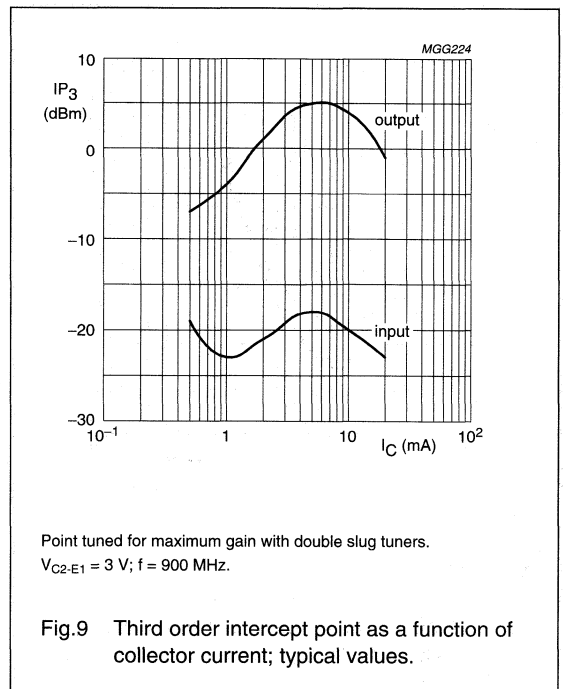
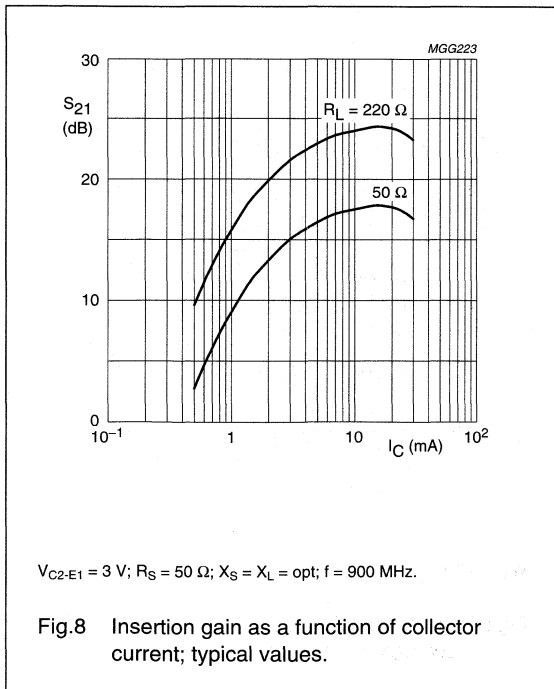
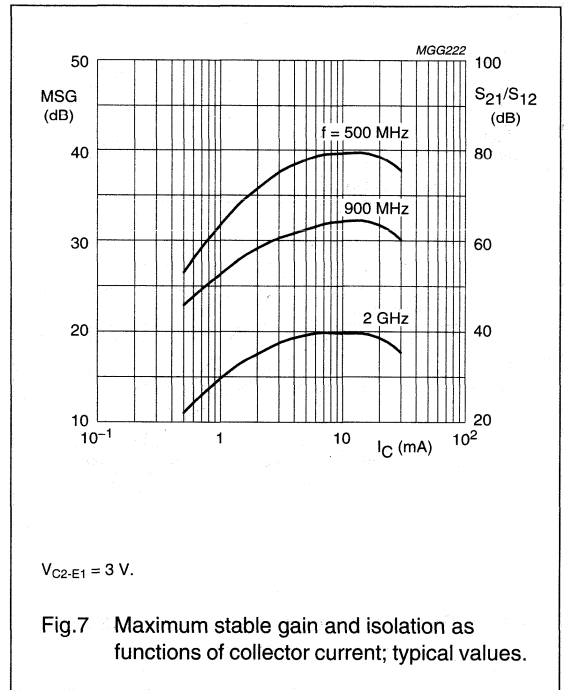
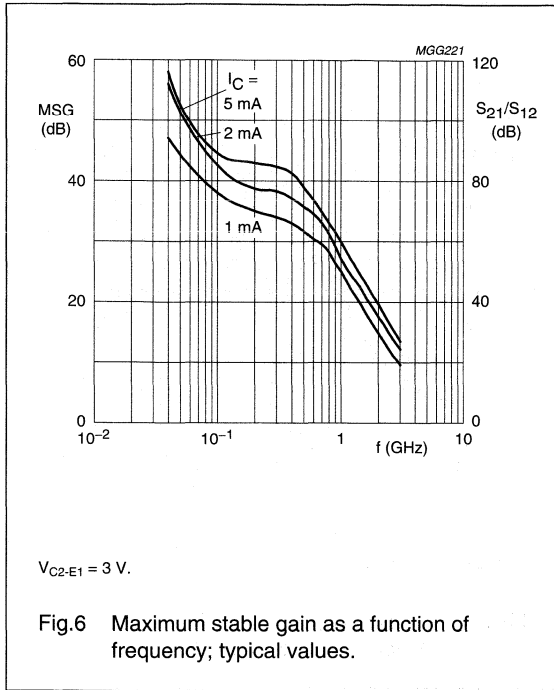


$V_{C2-E1} = 3 \text{ V}.$

Fig.5 Minimum noise figure as a function of collector current; typical values.

NPN wideband cascode transistor

BFC520



NPN wideband cascode transistor

BFC520

APPLICATION INFORMATION

SPICE parameters for any single BFC520 die

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 1 | IS | 1.016 | fA |
| 2 | BF | 220.1 | – |
| 3 | NF | 1.000 | – |
| 4 | VAF | 48.06 | V |
| 5 | IKF | 510.0 | mA |
| 6 | ISE | 283.0 | fA |
| 7 | NE | 2.035 | – |
| 8 | BR | 100.7 | – |
| 9 | NR | 0.988 | – |
| 10 | VAR | 1.692 | V |
| 11 | IKR | 2.352 | mA |
| 12 | ISC | 24.48 | aA |
| 13 | NC | 1.022 | – |
| 14 | RB | 10.00 | Ω |
| 15 | IRB | 1.000 | μA |
| 16 | RBM | 10.00 | Ω |
| 17 | RE | 775.3 | mΩ |
| 18 | RC | 2.210 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 1.245 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.258 | – |
| 25 | TF | 8.616 | ps |
| 26 | XTF | 6.788 | – |
| 27 | VTF | 1.414 | V |
| 28 | ITF | 110.3 | mA |
| 29 | PTF | 45.01 | deg |
| 30 | CJC | 447.6 | fF |
| 31 | VJC | 189.2 | mV |
| 32 | MJC | 0.071 | – |
| 33 | XCJC | 0.130 | – |
| 34 | TR | 543.7 | ps |
| 35 ⁽¹⁾ | CJS | 0.000 | F |
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.780 | – |

Note

- These parameters have not been extracted, the default values are shown.

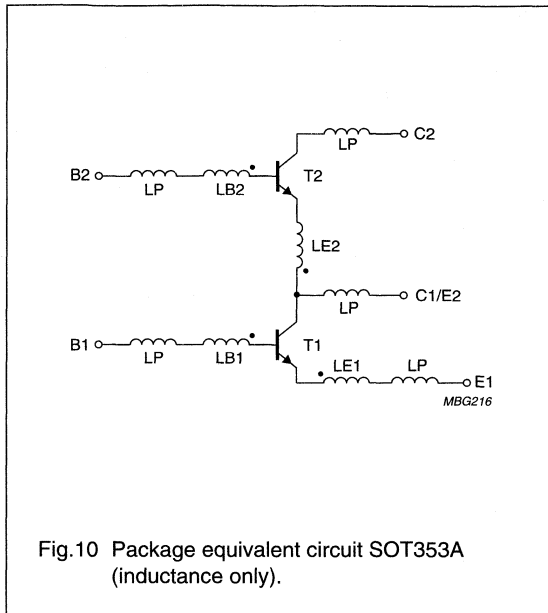


Fig.10 Package equivalent circuit SOT353A (inductance only).

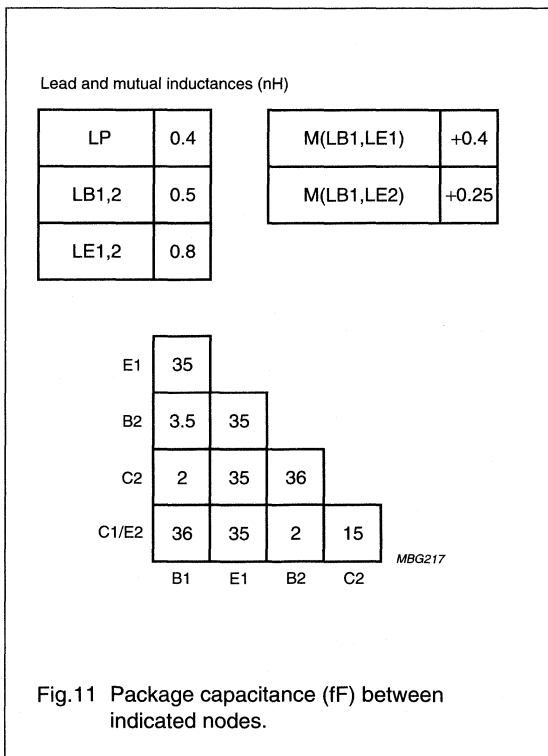
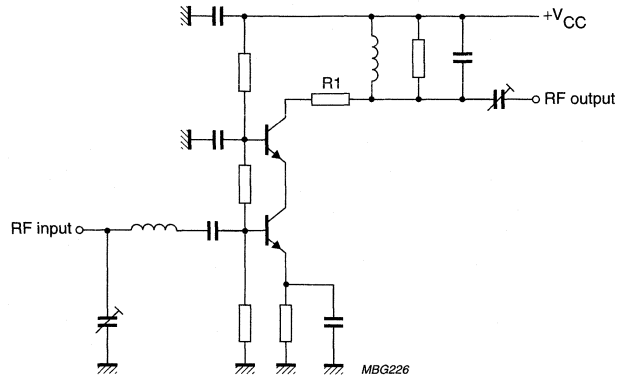


Fig.11 Package capacitance (fF) between indicated nodes.

NPN wideband cascode transistor

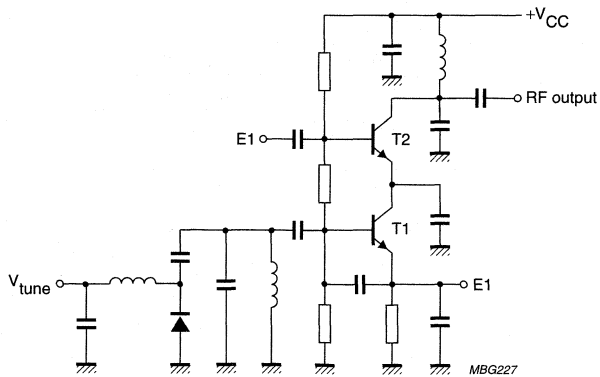
BFC520

Typical application circuits



R1 increases stability (10 to 47 Ω).

Fig.12 Narrowband amplifier.



T1 forms a colpitts oscillator.
T2 acts as a buffer amplifier.

Fig.13 VCO/buffer combination.

NPN wideband differential transistor

BFE505

FEATURES

- Small size
- High power gain at low bias current and voltage
- Temperature matched
- Balanced configuration
- h_{FE} matched
- Continues to operate at $V_{CE} < 1$ V.

APPLICATIONS

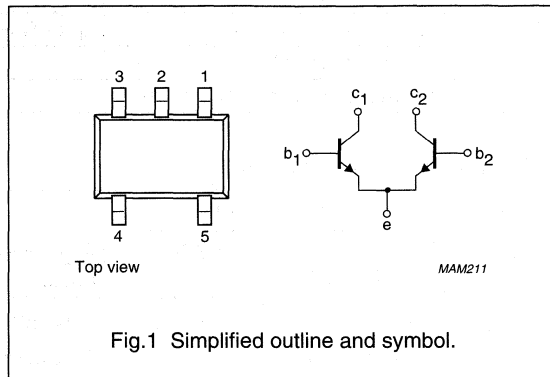
- Single balanced mixers
- Balanced amplifiers
- Balanced oscillators.

DESCRIPTION

Emitter coupled dual NPN silicon RF transistor in a surface mount, 5-pin SOT353 (S-mini) package. The transistor is primarily intended for applications in the RF front end as a balanced mixer, a differential amplifier in analog and digital cellular phones, and in cordless phones, pagers and satellite TV-tuners.

PINNING - SOT353B

| SYMBOL | PIN | DESCRIPTION |
|----------------|-----|-------------|
| b ₁ | 1 | base 1 |
| e | 2 | emitter |
| b ₂ | 3 | base 2 |
| c ₂ | 4 | collector 2 |
| c ₁ | 5 | collector 1 |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------------------|---|---|------|------|------|------|
| Any single transistor | | | | | | |
| C_{re} | feedback capacitance C_{BC} | $I_e = 0$; $V_{CB} = 3$ V; $f = 1$ MHz | – | 0.25 | 0.3 | pF |
| MSG/G_{max} | maximum power gain | $I_C = 5$ mA; $V_{CE} = 3$ V; $f = 900$ MHz | – | 17 | – | dB |
| | | $I_C = 5$ mA; $V_{CE} = 3$ V; $f = 2$ GHz | – | 10 | – | dB |
| F | noise figure | $I_C = 2$ mA; $V_{CE} = 3$ V; $f = 900$ MHz; $\Gamma_S = \Gamma_{opt}$ | – | 1.2 | 1.7 | dB |
| | | $I_C = 3$ mA; $V_{CE} = 3$ V; $f = 2$ GHz; $\Gamma_S = \Gamma_{opt}$ | – | 1.9 | 2.1 | dB |
| h_{FE} | DC current gain | $I_C = 5$ mA; $V_{CE} = 3$ V | 60 | 120 | 250 | |
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | single loaded | – | – | 230 | K/W |
| | | double loaded | – | – | 115 | K/W |

NPN wideband differential transistor

BFE505

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------------------|--------------------------------|--------------------------------------|------|------|------|
| Any single transistor | | | | | |
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ °C}$; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | +175 | °C |
| T_j | operating junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point; note 1 | single loaded | 230 | K/W |
| | | double loaded | 115 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.

NPN wideband differential transistor

BFE505

CHARACTERISTICS

 $T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--|---|---|------|------|------|------|
| DC characteristics of any single transistor | | | | | | |
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\ \mu\text{A}; I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 10\ \mu\text{A}; I_B = 0$ | 8 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 2.5\ \mu\text{A}; I_C = 0$ | 2.5 | – | – | V |
| I_{CBO} | collector-base leakage current | $I_E = 0; V_{CB} = 6\ \text{V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 5\ \text{mA}; V_{CE} = 6\ \text{V}$ | 60 | 120 | 250 | |
| DC characteristics of the dual transistor | | | | | | |
| Δh_{FE} | ratio of highest and lowest DC current gain | $I_{C1} = I_{C2} = 5\ \text{mA};$ $V_{CE1} = V_{CE2} = 6\ \text{V}$ | 1 | 1.2 | – | |
| ΔV_{BEO} | difference between highest and lowest base-emitter voltage (offset voltage) | $I_{E1} = I_{E2} = 10\ \text{mA}; T_{amb} = 25\text{ °C}$ | 0 | 1 | – | mV |
| AC characteristics of any single transistor | | | | | | |
| f_T | transition frequency | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V}; f = 1\ \text{GHz}$ | – | 9 | – | GHz |
| C_c | collector capacitance | $I_E = I_B = 0; V_{CB} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | 0.3 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | 0.25 | – | pF |
| MSG/G_{max} | maximum power gain; note 1 | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 900\ \text{MHz}; T_{amb} = 25\text{ °C}$ | – | 17 | – | dB |
| | | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 2\ \text{GHz}; T_{amb} = 25\text{ °C}$ | – | 10 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 900\ \text{MHz}; T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| F | noise figure | $I_C = 2\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 900\ \text{MHz}; \Gamma_S = \Gamma_{opt}$ | – | 1.2 | 1.7 | dB |
| | | $I_C = 3\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 2\ \text{GHz}; \Gamma_S = \Gamma_{opt}$ | – | 1.9 | 2.1 | dB |

Note

- Maximum gain of the differential amplifier is higher because of internal emitter connection (see Fig.2).

NPN wideband differential transistor

BFE505

APPLICATION INFORMATION

SPICE parameters for any single BFE505 die

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 1 | IS | 134.1 | aA |
| 2 | BF | 180.0 | – |
| 3 | NF | 0.988 | – |
| 4 | VAF | 38.34 | V |
| 5 | IKF | 150.0 | mA |
| 6 | ISE | 27.81 | fA |
| 7 | NE | 2.051 | – |
| 8 | BR | 55.19 | – |
| 9 | NR | 0.982 | – |
| 10 | VAR | 2.459 | V |
| 11 | IKR | 2.920 | mA |
| 12 | ISC | 17.45 | aA |
| 13 | NC | 1.062 | – |
| 14 | RB | 20.00 | Ω |
| 15 | IRB | 1.000 | μA |
| 16 | RBM | 20.00 | Ω |
| 17 | RE | 1.171 | Ω |
| 18 | RC | 4.350 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 284.7 | fF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.303 | – |
| 25 | TF | 7.037 | ps |
| 26 | XTF | 12.34 | – |
| 27 | VTF | 1.701 | V |
| 28 | ITF | 30.64 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 242.4 | fF |
| 31 | VJC | 188.6 | mV |
| 32 | MJC | 0.041 | – |
| 33 | XCJC | 0.130 | – |
| 34 | TR | 1.332 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.897 | – |

Note

- These parameters have not been extracted, the default values are shown.

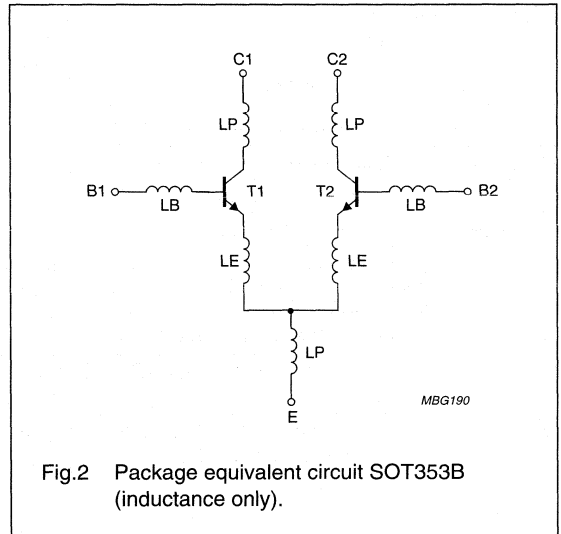


Fig.2 Package equivalent circuit SOT353B (inductance only).

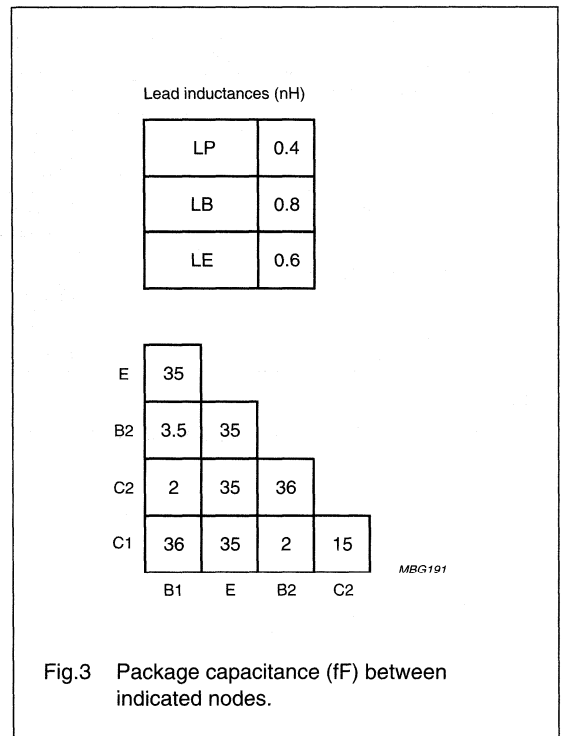


Fig.3 Package capacitance (fF) between indicated nodes.

NPN wideband differential transistor

BFE505

Typical application circuit

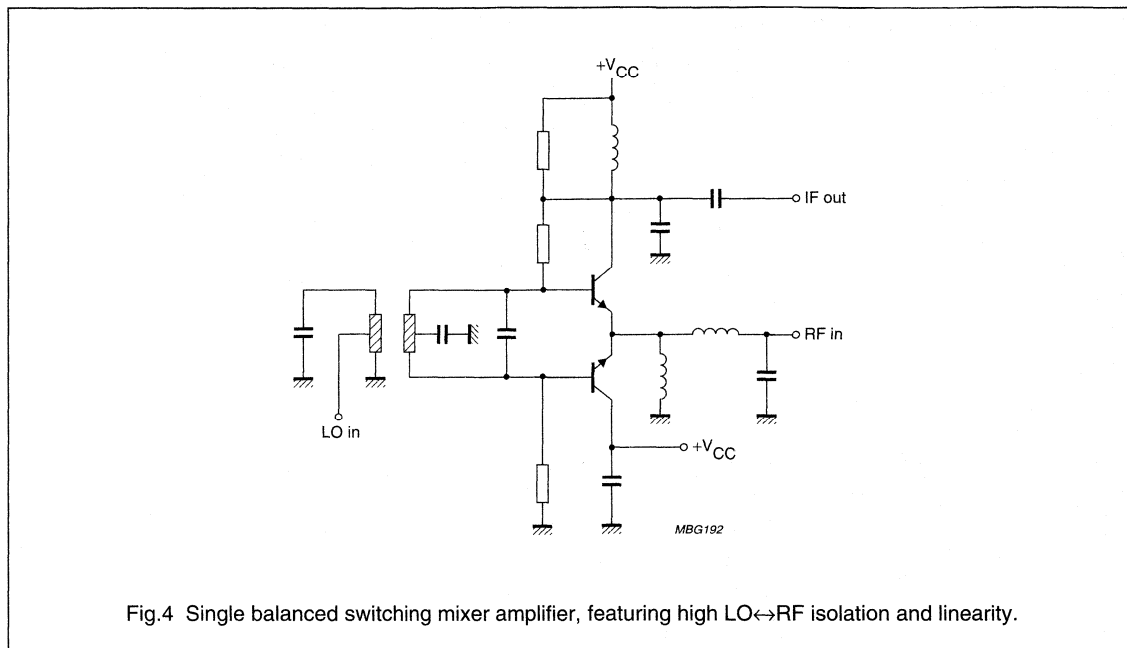


Fig.4 Single balanced switching mixer amplifier, featuring high LO \leftrightarrow RF isolation and linearity.

NPN wideband differential transistor

BFE520

FEATURES

- Small size
- High power gain at low bias current and voltage
- Temperature matched
- Balanced configuration
- h_{FE} matched
- Continues to operate at $V_{CE} < 1$ V.

APPLICATIONS

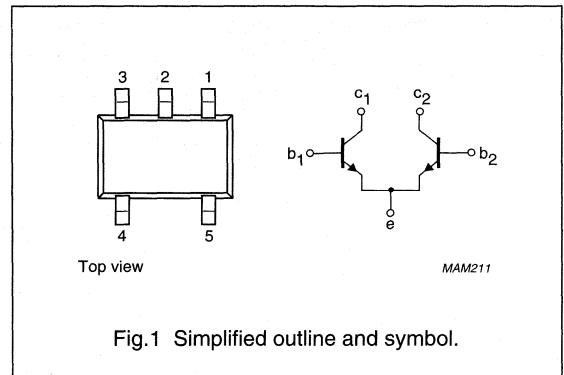
- Single balanced mixers
- Balanced amplifiers
- Balanced oscillators.

DESCRIPTION

Emitter coupled dual NPN silicon RF transistor in a surface mount 5-pin SOT353 (S-mini) package. The transistor is primarily intended for applications in the RF front end as a balanced mixer, a differential amplifier in analog and digital cellular phones, and in cordless phones, pagers and satellite TV-tuners.

PINNING - SOT353B

| PIN | SYMBOL | DESCRIPTION |
|----------------|--------|-------------|
| b ₁ | 1 | base 1 |
| e | 2 | emitter |
| b ₂ | 3 | base 2 |
| c ₂ | 4 | collector 2 |
| c ₁ | 5 | collector 1 |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------------------|---|---|------|------|------|------|
| Any single transistor | | | | | | |
| C_{re} | feedback capacitance C_{BC} | $I_e = 0$; $V_{CB} = 3$ V; $f = 1$ MHz | – | 0.35 | 0.4 | pF |
| MSG/G_{max} | maximum power gain | $I_C = 20$ mA; $V_{CE} = 3$ V; $f = 900$ MHz | – | 16 | – | dB |
| | | $I_C = 20$ mA; $V_{CE} = 3$ V; $f = 2$ GHz | – | 9 | – | dB |
| F | noise figure | $I_C = 5$ mA; $V_{CE} = 3$ V; $f = 900$ MHz; $\Gamma_S = \Gamma_{opt}$ | – | 1.1 | 1.6 | dB |
| | | $I_C = 5$ mA; $V_{CE} = 3$ V; $f = 2$ GHz; $\Gamma_S = \Gamma_{opt}$ | – | 1.9 | – | dB |
| h_{FE} | DC current gain | $I_C = 20$ mA; $V_{CE} = 3$ V | 60 | 120 | 250 | |
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | single loaded | – | – | 230 | K/W |
| | | double loaded | – | – | 115 | K/W |

NPN wideband differential transistor

BFE520

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------------------|---------------------------|--------------------------------------|------|------|------|
| Any single transistor | | | | | |
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ °C}$; note 1 | – | 1 | W |
| T_{stg} | storage temperature | | –65 | +175 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point; note 1 | single loaded | 230 | K/W |
| | | double loaded | 115 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.

NPN wideband differential transistor

BFE520

CHARACTERISTICS $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--|---|---|------|------|------|------|
| DC characteristics of any single transistor | | | | | | |
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\text{ }\mu\text{A}; I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 10\text{ }\mu\text{A}; I_B = 0$ | 8 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 2.5\text{ }\mu\text{A}; I_C = 0$ | 2.5 | – | – | V |
| I_{CBO} | collector-base leakage current | $I_E = 0; V_{CB} = 6\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| DC characteristics of the dual transistor | | | | | | |
| Δh_{FE} | ratio of highest and lowest DC current gain | $I_{C1} = I_{C2} = 20\text{ mA}; V_{CE1} = V_{CE2} = 6\text{ V}$ | 1 | 1.2 | – | |
| ΔV_{BEO} | difference between highest and lowest base-emitter voltage (offset voltage) | $I_{E1} = I_{E2} = 30\text{ mA}; T_{amb} = 25\text{ }^\circ\text{C}$ | 0 | 1 | – | mV |
| AC characteristics of any single transistor | | | | | | |
| f_T | transition frequency | $I_C = 20\text{ mA}; V_{CE} = 3\text{ V}; f = 1\text{ GHz}$ | – | 9 | – | GHz |
| C_c | collector capacitance | $I_E = I_e = 0; V_{CB} = 3\text{ V}; f = 1\text{ MHz}$ | – | 0.4 | 0.45 | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 3\text{ V}; f = 1\text{ MHz}$ | – | 0.35 | 0.4 | pF |
| MSG/G_{max} | maximum power gain; note 1 | $I_C = 20\text{ mA}; V_{CE} = 3\text{ V}; f = 900\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 16 | – | dB |
| | | $I_C = 20\text{ mA}; V_{CE} = 3\text{ V}; f = 2\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 9 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 20\text{ mA}; V_{CE} = 3\text{ V}; f = 900\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | 13 | 14 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}; V_{CE} = 3\text{ V}; f = 900\text{ MHz}; \Gamma_S = \Gamma_{opt}$ | – | 1.1 | 1.6 | dB |
| | | $I_C = 5\text{ mA}; V_{CE} = 3\text{ V}; f = 2\text{ GHz}; \Gamma_S = \Gamma_{opt}$ | – | 1.9 | – | dB |

Note

- Maximum gain of the differential amplifier is higher because of internal emitter connection (see Fig.2).

NPN wideband differential transistor

BFE520

APPLICATION INFORMATION

SPICE parameters for any single BFE520 die

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------------|
| 1 | IS | 1.016 | fA |
| 2 | BF | 220.1 | – |
| 3 | NF | 1.000 | – |
| 4 | VAF | 48.06 | V |
| 5 | IKF | 510.0 | mA |
| 6 | ISE | 283.0 | fA |
| 7 | NE | 2.035 | – |
| 8 | BR | 100.7 | – |
| 9 | NR | 0.988 | – |
| 10 | VAR | 1.692 | V |
| 11 | IKR | 2.352 | mA |
| 12 | ISC | 24.48 | aA |
| 13 | NC | 1.022 | – |
| 14 | RB | 10.00 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 10.00 | Ω |
| 17 | RE | 775.3 | m Ω |
| 18 | RC | 2.210 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 1.245 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.258 | – |
| 25 | TF | 8.616 | ps |
| 26 | XTF | 6.788 | – |
| 27 | VTF | 1.414 | V |
| 28 | ITF | 110.3 | mA |
| 29 | PTF | 45.01 | deg |
| 30 | CJC | 447.6 | fF |
| 31 | VJC | 189.2 | mV |
| 32 | MJC | 0.071 | – |
| 33 | XCJC | 0.130 | – |
| 34 | TR | 543.7 | ps |
| 35 ⁽¹⁾ | CJS | 0.000 | F |
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.780 | – |

Note

- These parameters have not been extracted, the default values are shown.

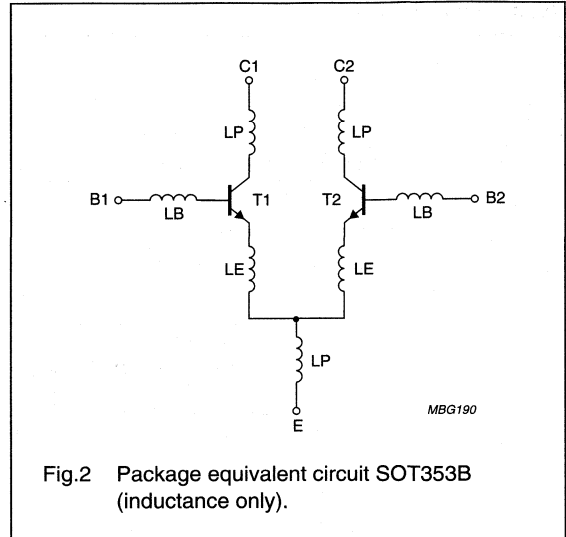


Fig.2 Package equivalent circuit SOT353B (inductance only).

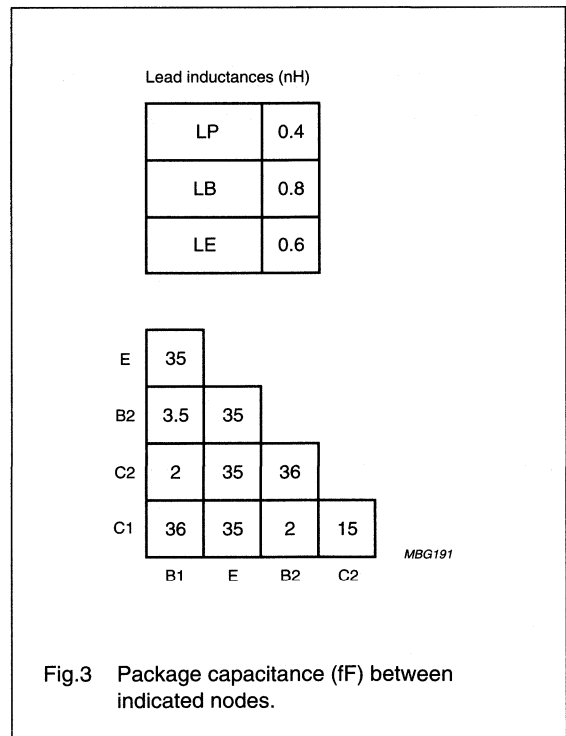


Fig.3 Package capacitance (fF) between indicated nodes.

NPN wideband differential transistor

BFE520

Typical application circuit

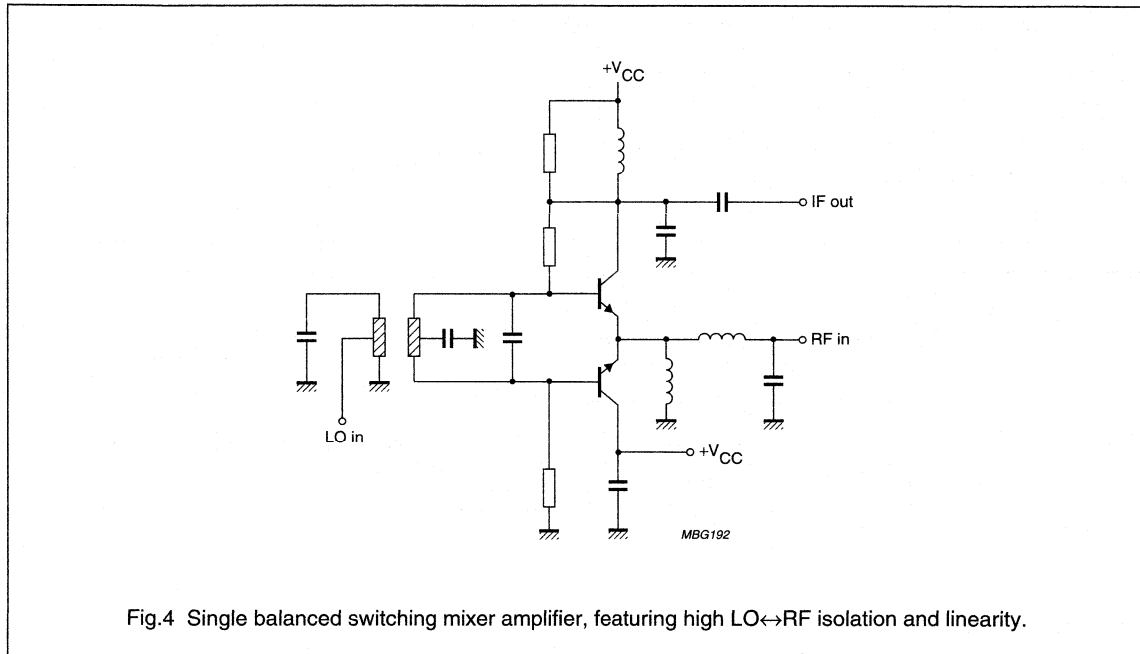


Fig.4 Single balanced switching mixer amplifier, featuring high LO↔RF isolation and linearity.

NPN 2 GHz RF power transistor

BFG10; BFG10/X

FEATURES

- High power gain
- High efficiency
- Small size discrete power amplifier
- 1.9 GHz operating area
- Gold metallization ensures excellent reliability.

APPLICATIONS

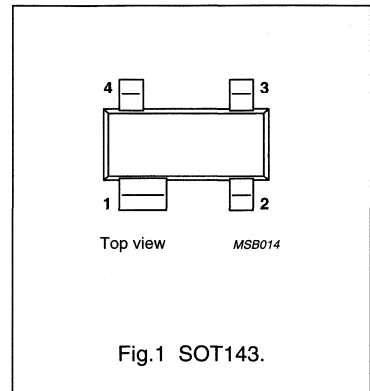
- Common emitter class-AB operation in hand-held radio equipment at 1.9 GHz.

DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in plastic, 4-pin dual-emitter SOT143 package.

PINNING

| PIN | DESCRIPTION |
|----------------------------|-------------|
| BFG10 (see Fig.1) | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG10/X (see Fig.1) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



MARKING

| TYPE NUMBER | CODE |
|-------------|------|
| BFG10 | N70 |
| BFG10/X | N71 |

QUICK REFERENCE DATA

RF performance at $T_{amb} = 25\text{ }^{\circ}\text{C}$ in a common-emitter test circuit (see Fig.7).

| MODE OF OPERATION | f (GHz) | V_{CE} (V) | P_L (mW) | G_p (dB) | η_c (%) |
|---------------------------------------|---------|--------------|------------|------------|--------------|
| Pulsed, class-AB, duty cycle: < 1 : 8 | 1.9 | 3.6 | 200 | ≥ 5 | ≥ 50 |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-------------|---------------------------|--|------|------|--------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 250 | mA |
| $I_{C(AV)}$ | average collector current | | – | 250 | mA |
| P_{tot} | total power dissipation | up to $T_s = 60\text{ }^{\circ}\text{C}$; see Fig.2; note 1 | – | 400 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^{\circ}\text{C}$ |
| T_j | junction temperature | | – | 175 | $^{\circ}\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 2 GHz RF power transistor

BFG10; BFG10/X

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 60\text{ }^\circ\text{C}$; note 1; $P_{tot} = 400\text{ mW}$ | 290 | K/W |

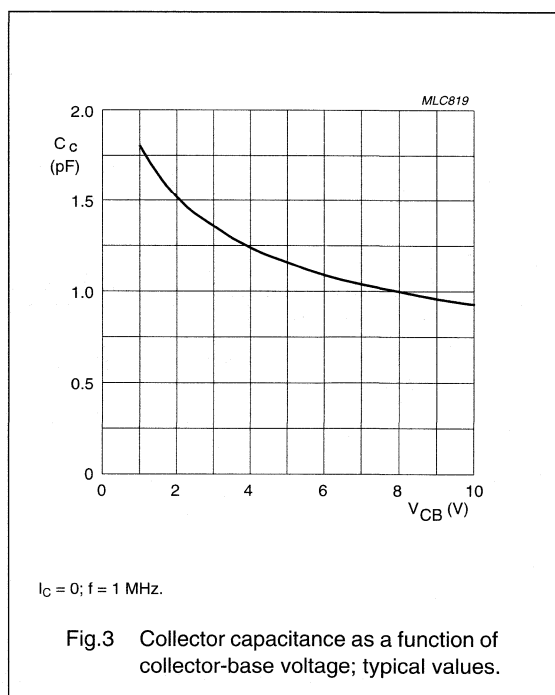
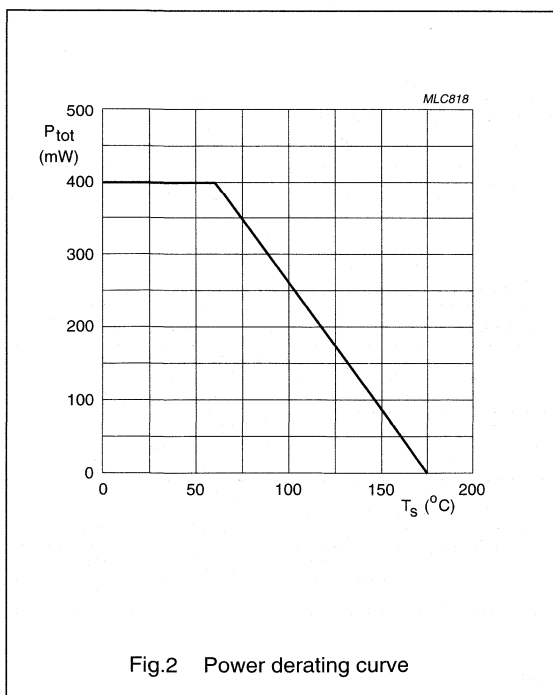
Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|---------------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 0.1\text{ mA}$ | 20 | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 5\text{ mA}$ | 8 | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.1\text{ mA}$ | 2.5 | – | V |
| I_{CES} | collector leakage current | $V_{CE} = 5\text{ V}$; $V_{BE} = 0$ | – | 100 | μA |
| h_{FE} | DC current gain | $I_C = 50\text{ mA}$; $V_{CE} = 5\text{ V}$ | 25 | – | |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 3.6\text{ V}$; $f = 1\text{ MHz}$ | – | 3 | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 3.6\text{ V}$; $f = 1\text{ MHz}$ | – | 2 | pF |



NPN 2 GHz RF power transistor

BFG10; BFG10/X

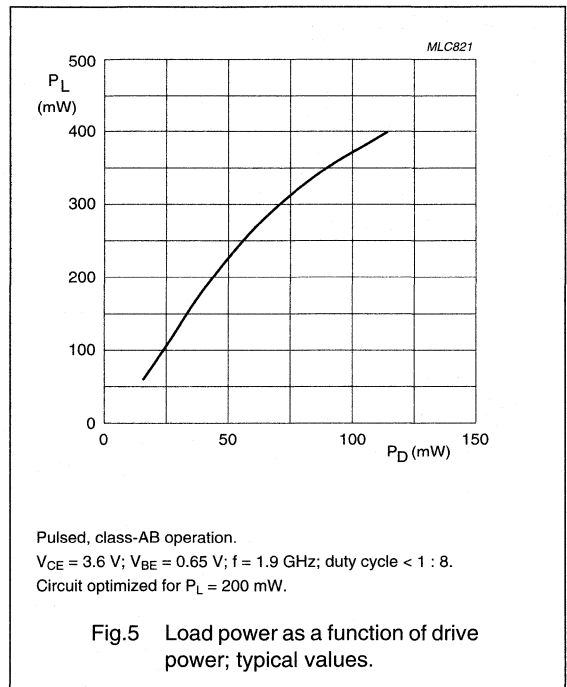
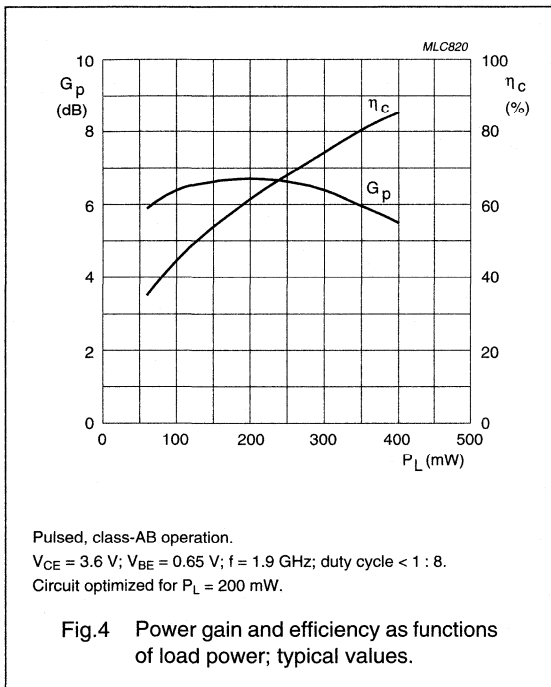
APPLICATION INFORMATION

RF performance at $T_{amb} = 25\text{ }^{\circ}\text{C}$ in a common-emitter test circuit (see Fig.7).

| MODE OF OPERATION | f (GHz) | V _{CE} (V) | I _{CQ} (mA) | P _L (mW) | G _p (dB) | η_c (%) |
|---------------------------------------|---------|---------------------|----------------------|---------------------|---------------------|----------------|
| Pulsed, class-AB, duty cycle: < 1 : 8 | 1.9 | 3.6 | 1 | 200 | >5 typ. 7 | >50 typ. 60 |

Ruggedness in class-AB operation

The BFG10 is capable of withstanding a load mismatch corresponding to VSWR = 8 : 1 through all phases, at rated output power under pulsed conditions up to a supply voltage of 7 V, f = 1.9 GHz and a duty cycle of 1 : 8.



NPN 2 GHz RF power transistor

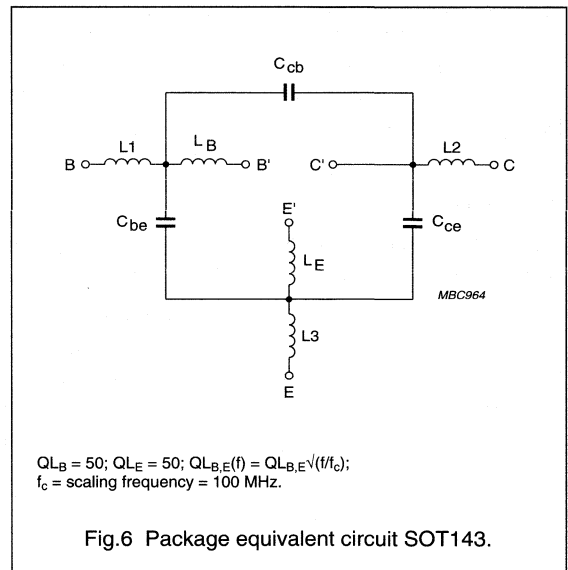
BFG10; BFG10/X

SPICE parameters for the BFG10 crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|----------|
| 1 | IS | 2.714 | fA |
| 2 | BF | 102.8 | – |
| 3 | NF | 0.998 | – |
| 4 | VAF | 28.12 | V |
| 5 | IKF | 6.009 | A |
| 6 | ISE | 403.2 | pA |
| 7 | NE | 2.937 | – |
| 8 | BR | 31.01 | – |
| 9 | NR | 0.999 | – |
| 10 | VAR | 2.889 | V |
| 11 | IKR | 0.284 | A |
| 12 | ISC | 1.487 | fA |
| 13 | NC | 1.100 | – |
| 14 | RB | 3.500 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 3.500 | Ω |
| 17 | RE | 0.217 | Ω |
| 18 | RC | 0.196 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 5.125 | pF |
| 23 | VJE | 0.600 | V |
| 24 | MJE | 0.367 | – |
| 25 | TF | 12.07 | ps |
| 26 | XTF | 99.40 | – |
| 27 | VTF | 7.220 | V |
| 28 | ITF | 3.950 | A |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 2.327 | pF |
| 31 | VJC | 0.668 | V |
| 32 | MJC | 0.398 | – |
| 33 | XCJC | 0.160 | – |
| 34 ⁽¹⁾ | TR | 0.000 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.652 | – |

Note

- These parameters have not been extracted, the default values are shown.



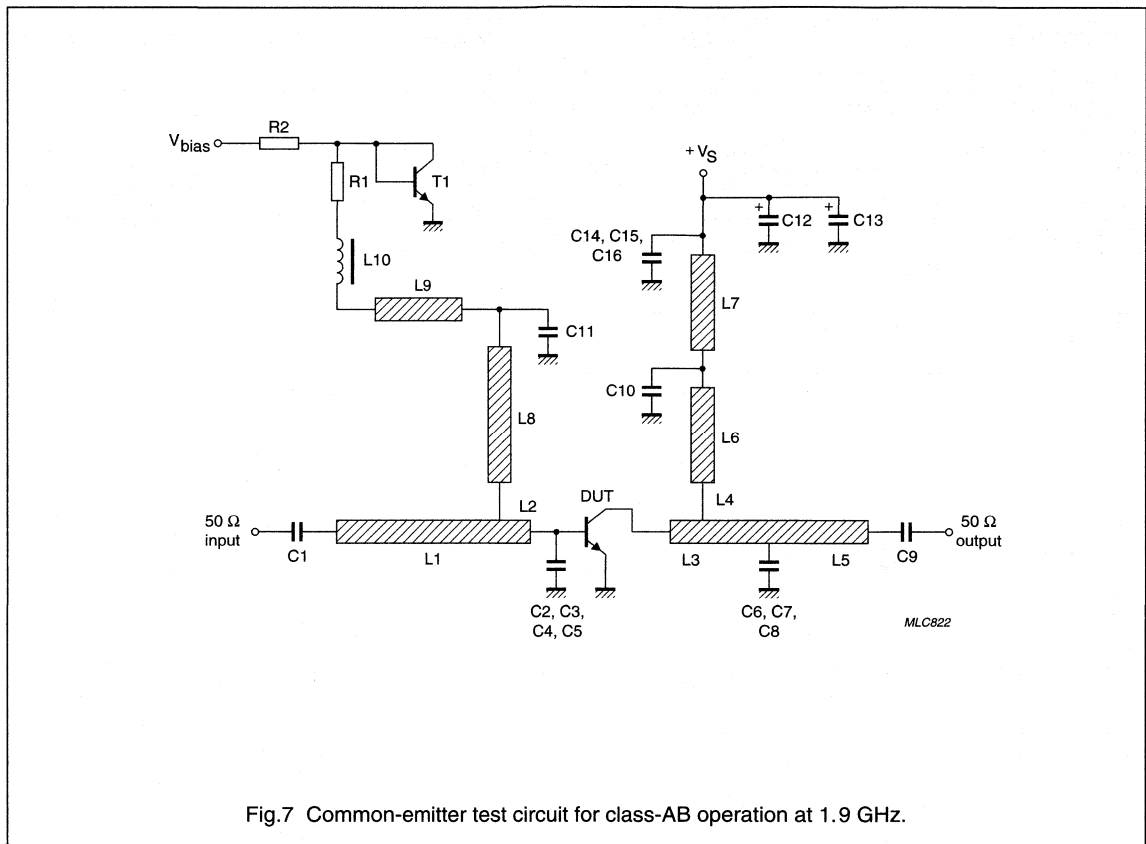
List of components (see Fig.6)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 84 | fF |
| C_{cb} | 17 | fF |
| C_{ce} | 191 | fF |
| L1 | 0.12 | nH |
| L2 | 0.21 | nH |
| L3 | 0.06 | nH |
| L_B | 0.95 | nH |
| L_E | 0.40 | nH |

NPN 2 GHz RF power transistor

BFG10; BFG10/X

Test circuit information



NPN 2 GHz RF power transistor

BFG10; BFG10/X

List of components used in test circuit (see Fig.7)

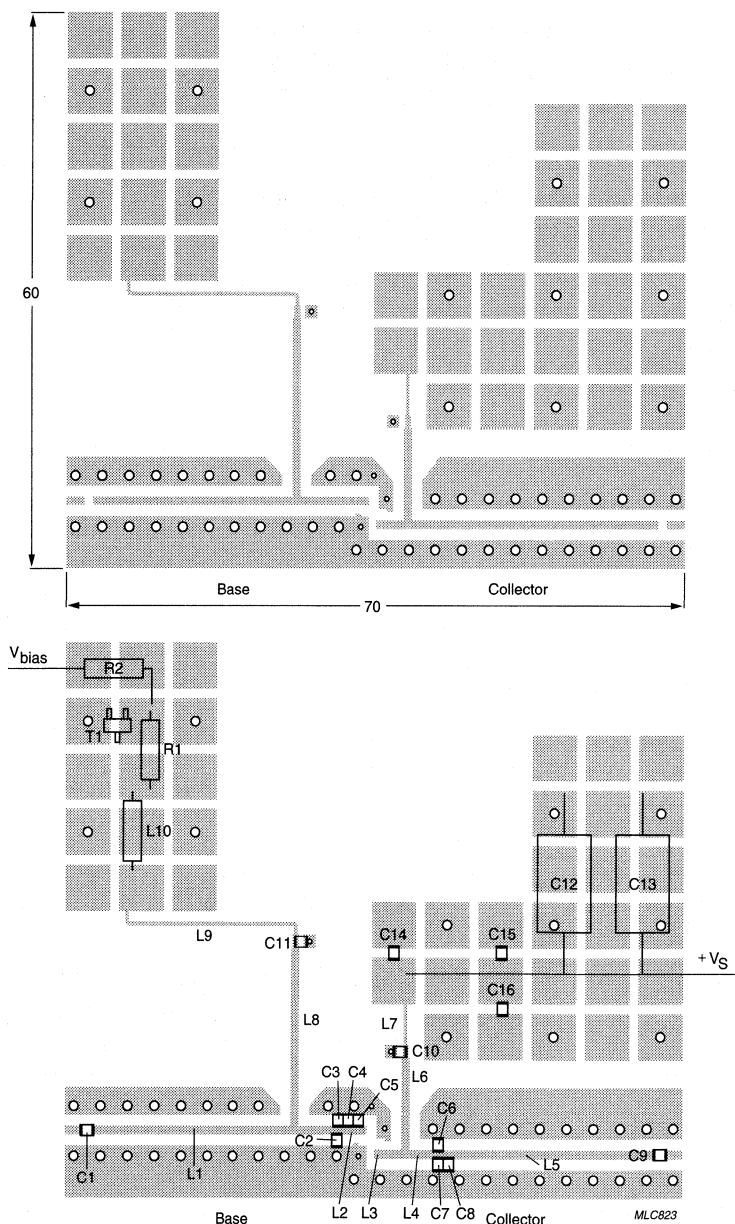
| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE No. |
|------------------------|---|----------------------|---------------------------------|----------------|
| C1, C9, C10, C11 | multilayer ceramic chip capacitor; note 1 | 24 pF | | |
| C2, C3, C4, C5, C6, C7 | multilayer ceramic chip capacitor; note 1 | 0.86 pF | | |
| C8 | multilayer ceramic chip capacitor; note 1 | 1.1 pF | | |
| C12, C13 | electrolytic capacitor | 470 μ F; 10 V | | 2222 031 34471 |
| C14, C15, C16 | multilayer ceramic chip capacitor; note 1 | 10 nF | | |
| L1 | stripline; note 2 | | length 28.5 mm width 0.93 mm | |
| L2 | stripline; note 2 | | length 2.3 mm width 0.93 mm | |
| L3 | stripline; note 2 | | length 3.1 mm width 0.93 mm | |
| L4 | stripline; note 2 | | length 3.3 mm width 0.93 mm | |
| L5 | stripline; note 2 | | length 16.3 mm width 0.93 mm | |
| L6 | stripline; note 2 | | length 10 mm width 0.93 mm | |
| L7 | stripline; note 2 | | length 4.4 mm width 0.4 mm | |
| L8 | stripline; note 2 | | length 19.3 mm width 0.93 mm | |
| L9 | stripline; note 2 | | length 19.7 mm width 0.4 mm | |
| L10 | micro choke | | | |
| T1 | BD228 | | | |
| R1 | metal film resistor | 20 Ω ; 0.4 W | | 2322 157 10209 |
| R2 | metal film resistor | 530 Ω ; 0.4 W | | 2322 157 15301 |

Notes

- American Technical Ceramics (ATC) capacitor, type 100A or other capacitor of the same quality.
- The striplines are on a $\frac{1}{32}$ inch double copper-clad printed-circuit board with PTFE fibre-glass dielectric ($\epsilon_r = 6$).

NPN 2 GHz RF power transistor

BFG10; BFG10/X



Dimensions in mm.

The components are situated on one side of the copper-clad PTFE microfibre-glass board, the other side is not etched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.8 Printed-circuit board and component lay-out for common-emitter test circuit in Fig.7.

UHF power transistor

BFG10W/X

FEATURES

- High efficiency
- Small size discrete power amplifier
- 900 MHz and 1.9 GHz operating areas
- Gold metallization ensures excellent reliability.

APPLICATIONS

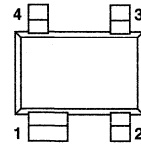
- Common emitter class-AB operation in hand-held radio equipment up to 1.9 GHz.

DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a plastic, 4-pin dual-emitter SOT343 package.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



Top view

MBK523

Marking code: T5.

Fig.1 SOT343.

QUICK REFERENCE DATA

RF performance at $T_{amb} = 25\text{ }^{\circ}\text{C}$ in a common-emitter test circuit.

| MODE OF OPERATION | f (GHz) | V_{CE} (V) | P_L (mW) | G_p (dB) | η_c (%) |
|--|---------|--------------|------------|-------------|--------------|
| Pulsed, class-AB, duty cycle: < 1 : 2; $t_p = 10\text{ ms}$ | 1.9 | 3.6 | 200 | ≥ 5 | ≥ 50 |
| Pulsed, class-AB, duty cycle: < 1 : 8; $t_p = 4.6\text{ ms}$ | 0.9 | 6 | 650 | ≥ 10 | ≥ 50 |
| | 0.9 | 6 | 360 | ≥ 12.5 | ≥ 50 |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-------------|---------------------------|--|------|------|--------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 250 | mA |
| $I_{C(AV)}$ | average collector current | | – | 250 | mA |
| P_{tot} | total power dissipation | up to $T_s = 102\text{ }^{\circ}\text{C}$; note 1 | – | 400 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^{\circ}\text{C}$ |
| T_j | junction temperature | | – | 175 | $^{\circ}\text{C}$ |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 102\text{ }^{\circ}\text{C}$; note 1; $P_{tot} = 400\text{ mW}$ | 180 | K/W |

Note to the Limiting values and Thermal characteristics

1. T_s is the temperature at the soldering point of the collector pin.

UHF power transistor

BFG10W/X

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ (unless otherwise specified).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|---------------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 0.1\text{ mA}$ | 20 | — | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 5\text{ mA}$ | 10 | — | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.1\text{ mA}$ | 2.5 | — | V |
| I_{CES} | collector cut-off current | $V_{CE} = 6\text{ V}; V_{BE} = 0$ | — | 100 | μA |
| h_{FE} | DC current gain | $I_C = 50\text{ mA}; V_{CE} = 5\text{ V}$ | 25 | — | |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 6\text{ V}; f = 1\text{ MHz}$ | — | 3 | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = 6\text{ V}; f = 1\text{ MHz}$ | — | 2 | pF |

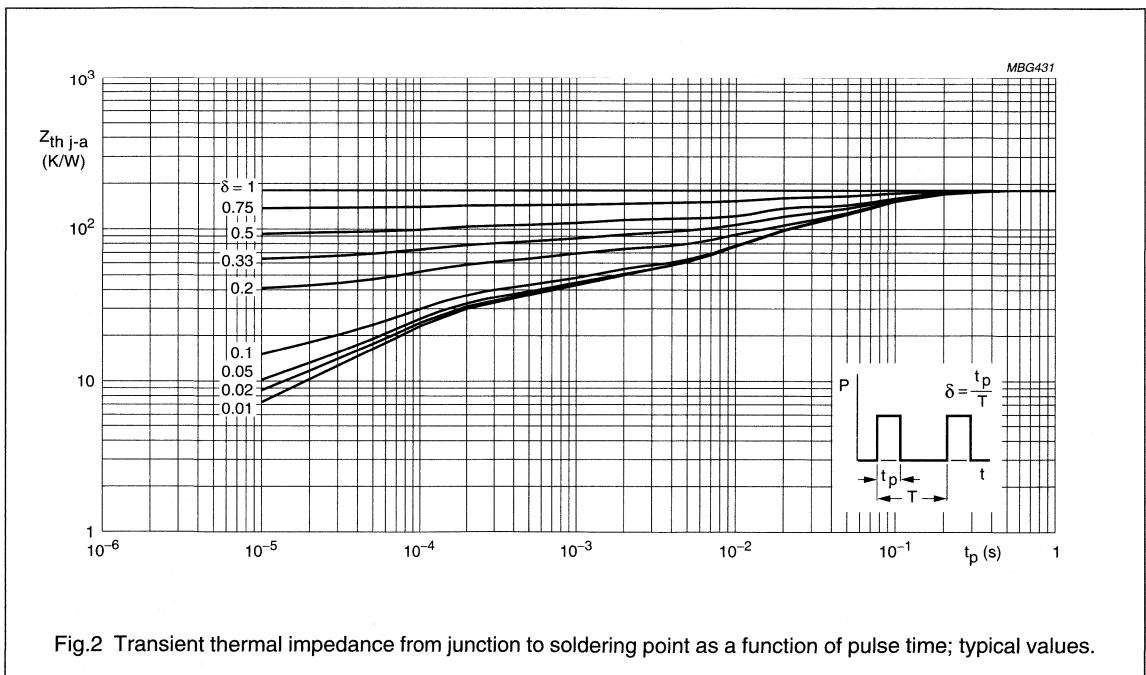


Fig.2 Transient thermal impedance from junction to soldering point as a function of pulse time; typical values.

UHF power transistor

BFG10W/X

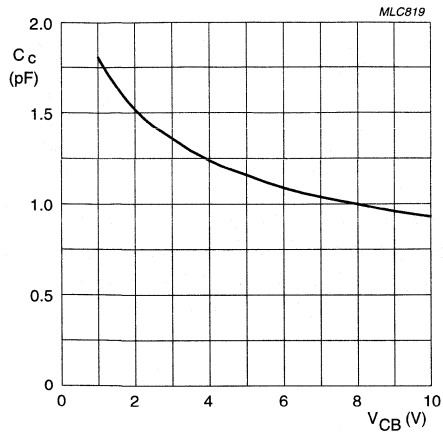


Fig.3 Collector capacitance as a function of collector-base voltage.

UHF power transistor

BFG10W/X

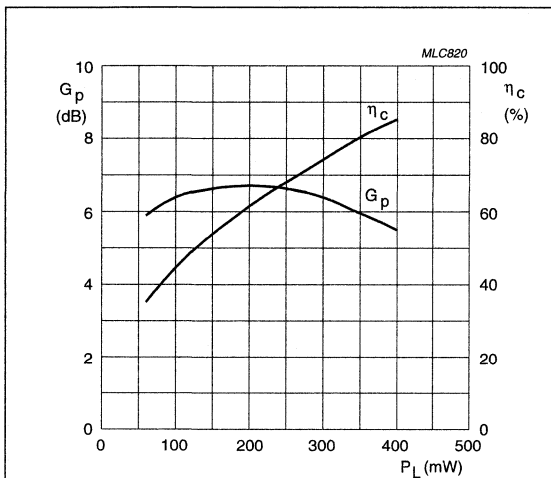
APPLICATION INFORMATION

RF performance at $T_{amb} = 25\text{ }^{\circ}\text{C}$ in a common-emitter test circuit.

| MODE OF OPERATION | f (GHz) | V _{CE} (V) | P _L (mW) | G _p (dB) | η_c (%) |
|---|---------|---------------------|---------------------|---------------------|---------------------|
| Pulsed, class-AB, duty cycle: < 1 : 2; $t_p = 10\text{ ms}$ | 1.9 | 3.6 | 200 | ≥ 5 ; typ. 7 | ≥ 50 ; typ. 60 |
| Pulsed, class-AB, duty cycle: < 1 : 8; $t_p = 5\text{ ms}$ | 0.9 | 6 | 650 | ≥ 10 | ≥ 50 |
| | 0.9 | 6 | 360 | ≥ 12.5 | ≥ 50 |

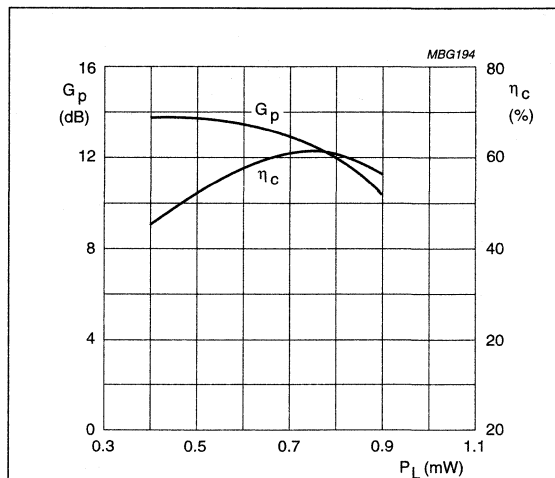
Ruggedness in class-AB operation

The BFG10W/X is capable of withstanding a load mismatch corresponding to VSWR = 6 : 1 through all phases under pulsed conditions up to a supply voltage of 8.6 V under the conditions: 900 MHz; 650 mW; $t_p = 4.6\text{ ms}$; duty cycle of 1 : 8 and up to a supply voltage of 5.5 V under the conditions: 1.9 GHz; 200 mW; $t_p = 10\text{ ms}$; duty cycle of 1 : 2.



Pulsed, class-AB operation.
 $V_{CE} = 3.6\text{ V}$; $f = 1.9\text{ GHz}$; duty cycle < 1 : 2.
 Circuit optimized for $P_L = 200\text{ mW}$.

Fig.4 Power gain and efficiency as functions of load power; typical values.



Pulsed, class-AB operation.
 $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; duty cycle < 1 : 8.
 Circuit optimized for $P_L = 600\text{ mW}$.

Fig.5 Power gain and efficiency as functions of load power; typical values.

UHF power transistor

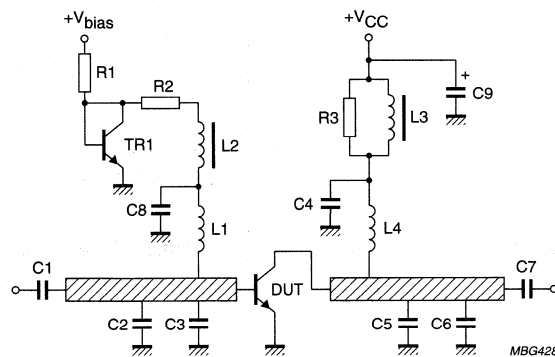
BFG10W/X

List of components (see Fig.6)

| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE No. |
|------------|--------------------------------------|--------------------|---------------|----------------|
| TR1 | bias transistor, BC548 or equivalent | note 1 | | |
| C1, C4, C7 | capacitor; notes 2 and 3 | 120 pF | | |
| C2 | capacitor; note 2 | 6.8 pF | | |
| C3 | capacitor; note 2 | 0.5 pF | | |
| C5 | capacitor; note 2 | 1.2 pF | | |
| C6 | capacitor; note 2 | 1.9 pF | | |
| C8 | Philips multilayer capacitor | 1 nF, 10 V | | |
| C9 | Philips capacitor | 1500 μ F, 10 V | | 2222 032 14152 |
| L1 | 6 turns enamelled 0.7 mm copper wire | | length 3.5 mm | |
| L4 | 2 turns enamelled 0.7 mm copper wire | | length 3 mm | |
| L2, L3 | RF choke, Philips | | | 4312 020 36690 |
| R1 | metal film resistor | 275 Ω | | |
| R2 | metal film resistor | 100 Ω | | |
| R3 | metal film resistor | 10 Ω | | |

Notes

- V_{BE} at 1 mA must be 0.65 V.
- American Technical Ceramics type 100A or capacitor of same quality.
- Resonant at 1900 MHz.



PCB RT5880, thickness 0.79 mm.

Fig.6 Class-AB test circuit at $f = 900$ MHz.

UHF power transistor

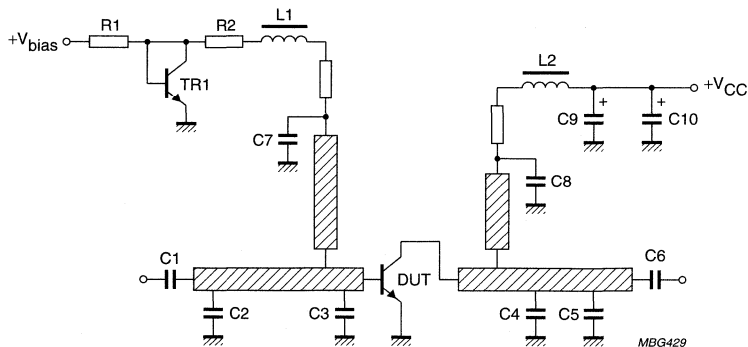
BFG10W/X

List of components (see Fig.6)

| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE No. |
|----------------|--------------------------------------|--------------------|------------|----------------|
| TR1 | bias transistor, BC548 or equivalent | note 1 | | |
| C1, C6, C7, C8 | capacitor; notes 2 and 3 | 24 pF | | |
| C2 | capacitor; note 2 | 0.4 pF | | |
| C3 | capacitor; note 2 | 2.4 pF | | |
| C4 | capacitor; note 2 | 0.5 pF | | |
| C5 | capacitor; note 2 | 1.2 pF | | |
| C9, C10 | Philips capacitor | 1500 μ F, 10 V | | 2222 032 14152 |
| L1, L2 | RF choke, Philips | | | 4330 030 36301 |
| R1, R2 | metal film resistor | 75 Ω | | |
| R3, R4 | metal film resistor | 10 Ω | | |

Notes

1. V_{BE} at 1 mA must be 0.65 V.
2. American Technical Ceramics type 100A or capacitor of same quality.
3. Resonant at 1900 MHz.



PCB RT5880, thickness 0.79 mm.

Fig.7 Class-AB test circuit at $f = 1.9$ GHz.

NPN 2 GHz RF power transistor

BFG11; BFG11/X

FEATURES

- High power gain
- High efficiency
- Small size discrete power amplifier
- 1.9 GHz operating area
- Gold metallization ensures excellent reliability.

APPLICATIONS

- Common emitter class-AB operation in hand-held radio equipment at 1.9 GHz.

PINNING

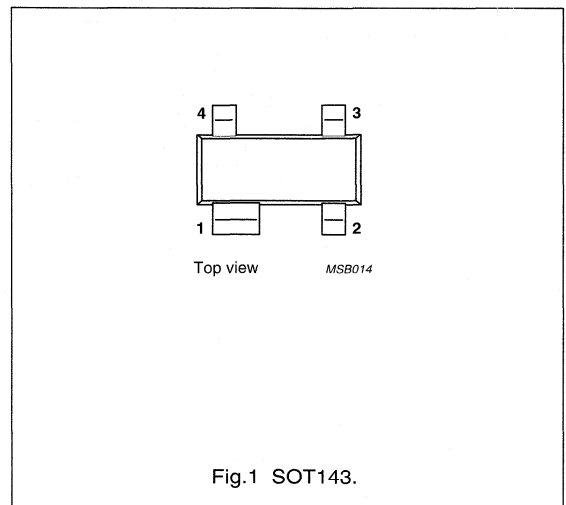
| PIN | DESCRIPTION |
|----------------------------|-------------|
| BFG11 (see Fig.1) | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG11/X (see Fig.1) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |

DESCRIPTION

NPN silicon planar epitaxial transistors encapsulated in a plastic, 4-pin dual-emitter SOT143 package.

MARKING

| TYPE NUMBER | CODE |
|-------------|------|
| BFG11 | N72 |
| BFG11/X | N73 |



QUICK REFERENCE DATA

RF performance at $T_{amb} = 25\text{ }^{\circ}\text{C}$ in a common-emitter test circuit (see Fig.7).

| MODE OF OPERATION | f (GHz) | V_{CE} (V) | P_L (mW) | G_p (dB) | η_c (%) |
|--------------------------------------|---------|--------------|------------|------------|--------------|
| Pulsed, class-AB, duty cycle < 1 : 8 | 1.9 | 3.6 | 400 | ≥ 4 | ≥ 50 |

NPN 2 GHz RF power transistor

BFG11; BFG11/X

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

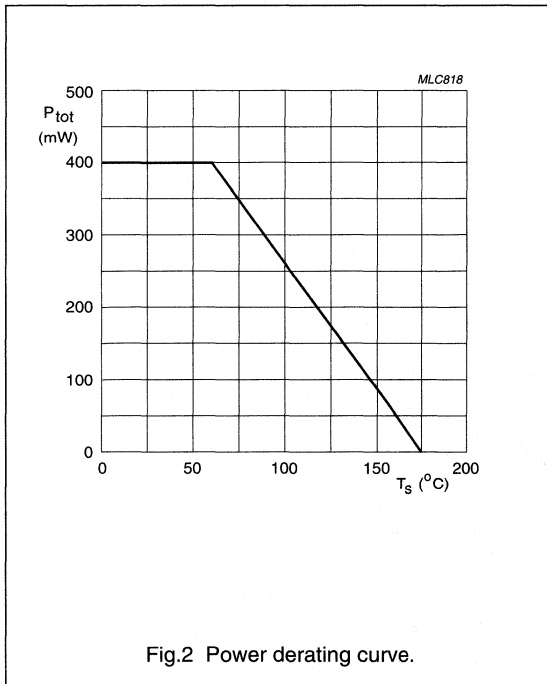
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-------------|---------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 500 | mA |
| $I_{C(AV)}$ | average collector current | | – | 500 | mA |
| P_{tot} | total power dissipation | up to $T_s = 60\text{ °C}$; note 1; see Fig.2 | – | 400 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 60\text{ °C}$; note 1; $P_{tot} = 400\text{ mW}$ | 290 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.



NPN 2 GHz RF power transistor

BFG11; BFG11/X

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|---------------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 0.1\text{ mA}$; $I_E = 0$ | 20 | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 10\text{ mA}$; $I_B = 0$ | 8 | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.1\text{ mA}$; $I_C = 0$ | 2.5 | – | V |
| I_{CES} | collector cut-off current | $V_{CE} = 8\text{ V}$; $V_{BE} = 0$ | – | 100 | μA |
| h_{FE} | DC current gain | $I_C = 100\text{ mA}$; $V_{CE} = 5\text{ V}$ | 25 | – | |
| C_c | collector capacitance | $I_E = I_e = 0$; $V_{CB} = 3.6\text{ V}$; $f = 1\text{ MHz}$ | – | 4 | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 3.6\text{ V}$; $f = 1\text{ MHz}$ | – | 3 | pF |

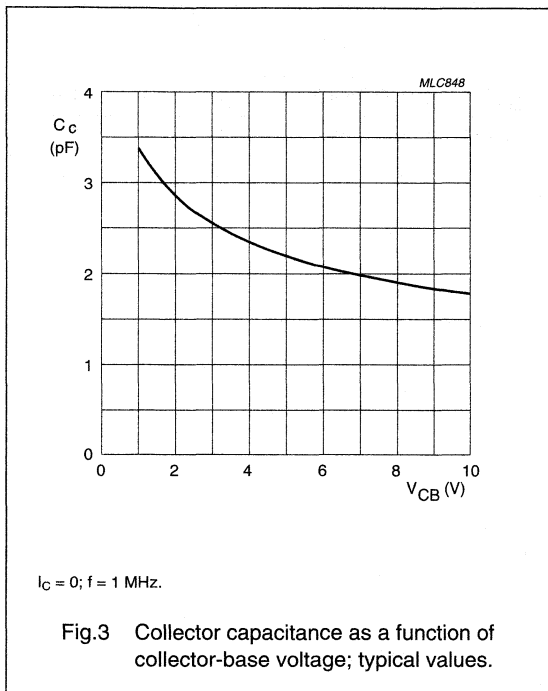


Fig.3 Collector capacitance as a function of collector-base voltage; typical values.

NPN 2 GHz RF power transistor

BFG11; BFG11/X

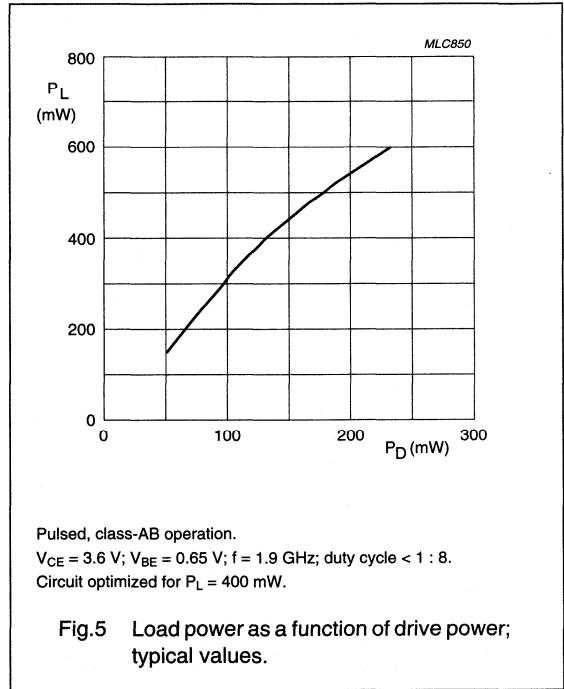
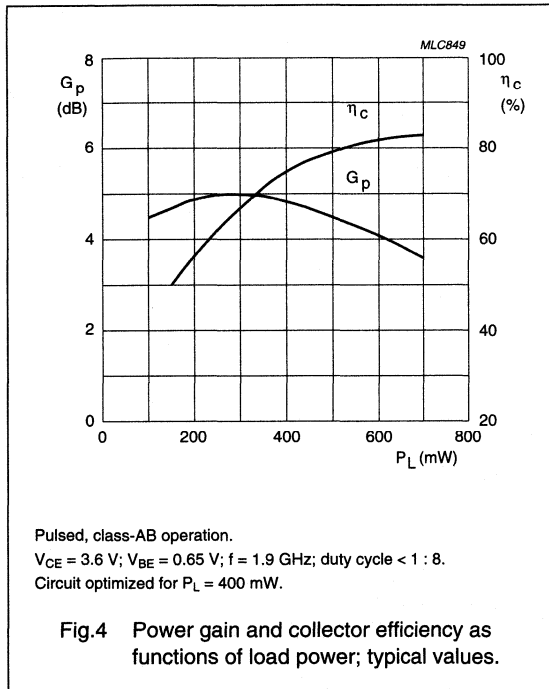
APPLICATION INFORMATION

RF performance at $T_{amb} = 25\text{ }^{\circ}\text{C}$ in a common-emitter test circuit (see Fig.7).

| MODE OF OPERATION | f (GHz) | V _{CE} (V) | I _{CQ} (mA) | P _L (mW) | G _p (dB) | η_c (%) |
|--------------------------------------|---------|---------------------|----------------------|---------------------|---------------------|----------------|
| Pulsed, class-AB, duty cycle < 1 : 8 | 1.9 | 3.6 | 1 | 400 | ≥4 typ. 5 | ≥50 typ. 70 |

Ruggedness in class-AB operation

The BFG11 is capable of withstanding a load mismatch corresponding to VSWR = 8 : 1 through all phases, at rated output power under pulsed conditions up to a supply voltage of 8 V, f = 1.9 GHz and a duty cycle of 1 : 8.



NPN 2 GHz RF power transistor

BFG11; BFG11/X

SPICE parameters for the BFG11 crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------------|
| 1 | IS | 3.338 | fA |
| 2 | BF | 97.14 | - |
| 3 | NF | 0.988 | - |
| 4 | VAF | 31.40 | V |
| 5 | IKF | 51.45 | A |
| 6 | ISE | 23.53 | pA |
| 7 | NE | 2.386 | - |
| 8 | BR | 13.73 | - |
| 9 | NR | 0.989 | - |
| 10 | VAR | 2.448 | V |
| 11 | IKR | 100.0 | A |
| 12 | ISC | 54.10 | fA |
| 13 | NC | 1.224 | - |
| 14 | RB | 1.740 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 1.740 | Ω |
| 17 | RE | 59.65 | m Ω |
| 18 | RC | 0.124 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | - |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | - |
| 22 | CJE | 9.555 | pF |
| 23 | VJE | 0.600 | V |
| 24 | MJE | 0.315 | - |
| 25 | TF | 12.96 | ps |
| 26 | XTF | 400.0 | - |
| 27 | VTF | 0.866 | V |
| 28 | ITF | 5.940 | A |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 4.274 | pF |
| 31 | VJC | 0.650 | V |
| 32 | MJC | 0.392 | - |
| 33 | XCJC | 0.150 | - |
| 34 ⁽¹⁾ | TR | 0.000 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | - |
| 38 | FC | 0.742 | - |

Note

- These parameters have not been extracted, the default values are shown.

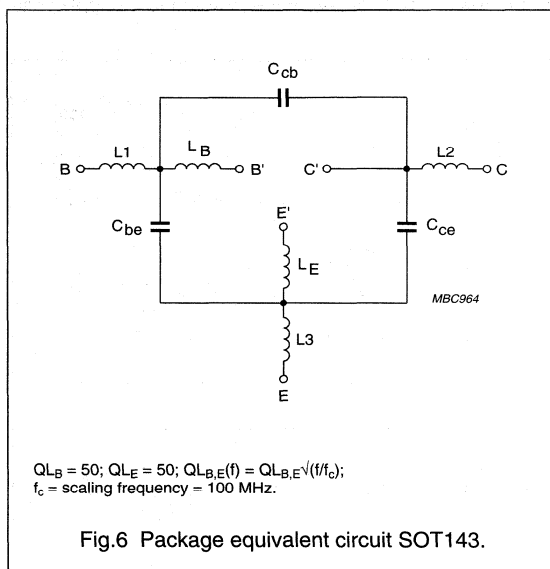


Fig.6 Package equivalent circuit SOT143.

List of components (see Fig.6)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 84 | fF |
| C_{cb} | 17 | fF |
| C_{ce} | 191 | fF |
| L1 | 0.12 | nH |
| L2 | 0.21 | nH |
| L3 | 0.06 | nH |
| L_B | 0.95 | nH |
| L_E | 0.40 | nH |

NPN 2 GHz RF power transistor

BFG11; BFG11/X

Test circuit information

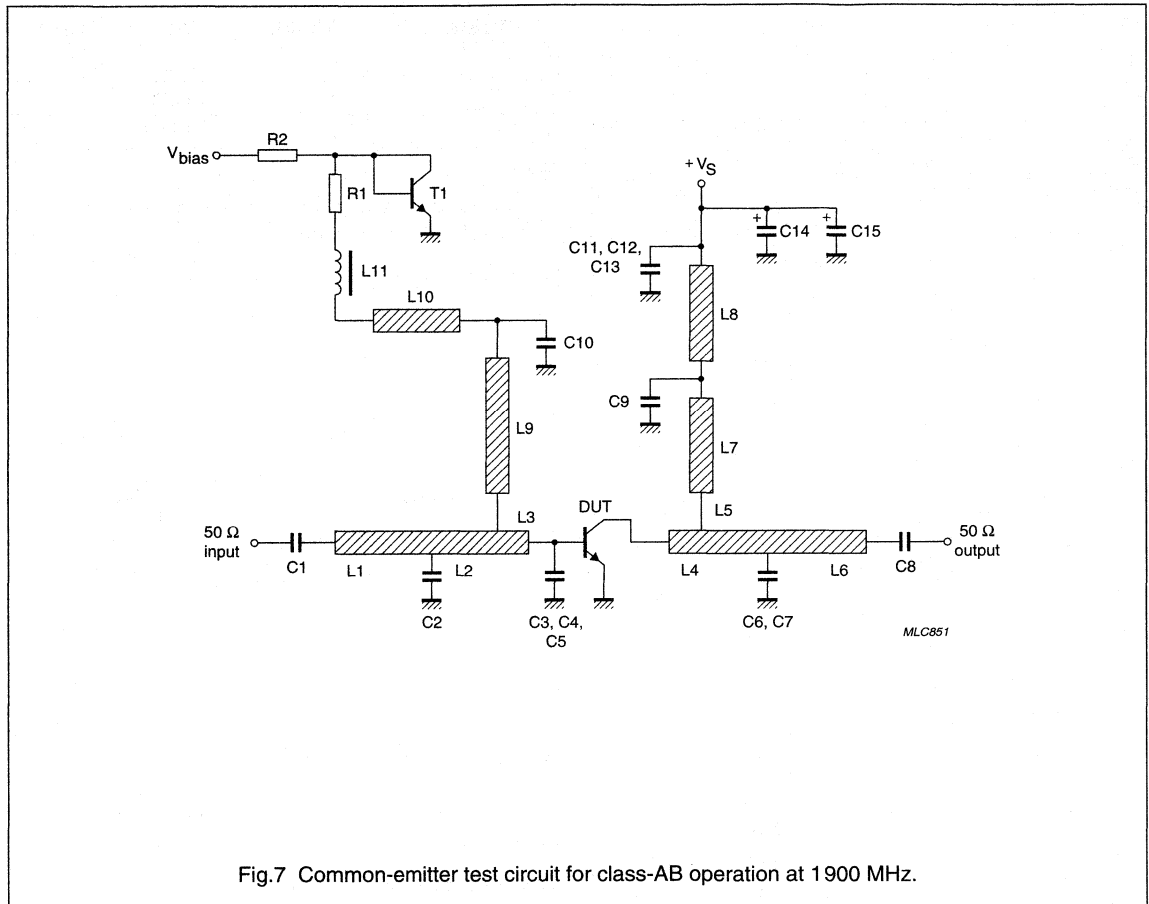


Fig.7 Common-emitter test circuit for class-AB operation at 1900 MHz.

NPN 2 GHz RF power transistor

BFG11; BFG11/X

List of components used in test circuit (see Fig.8)

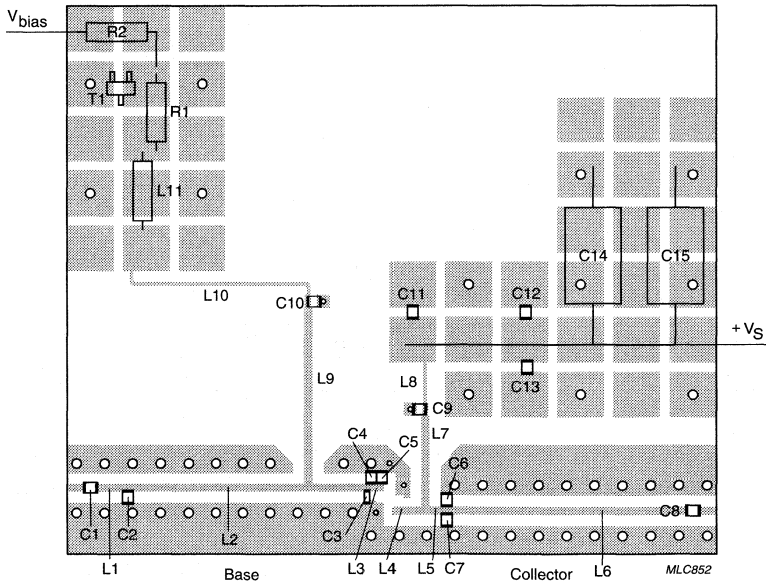
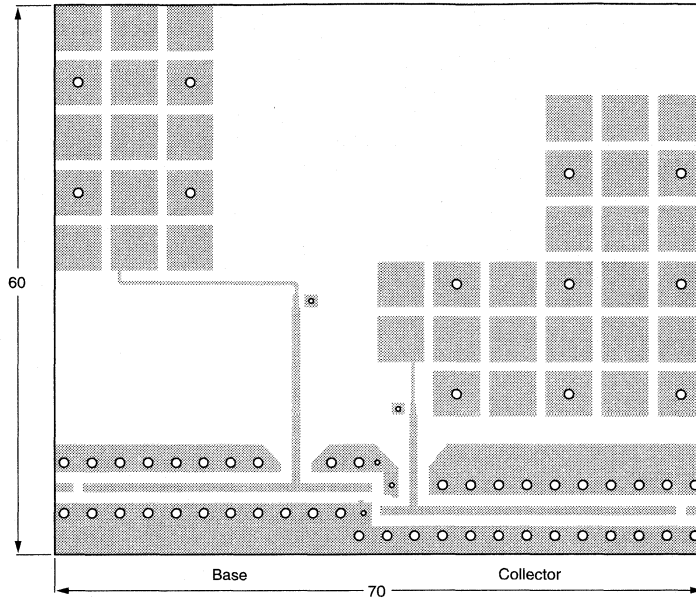
| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE NO. |
|-----------------|---|----------------------|---------------------------------|----------------|
| C1, C8, C9, C10 | multilayer ceramic chip capacitor; note 1 | 24 pF | | |
| C2 | multilayer ceramic chip capacitor; note 1 | 0.4 pF | | |
| C3 | multilayer ceramic chip capacitor; note 1 | 0.6 pF | | |
| C4, C7 | multilayer ceramic chip capacitor; note 1 | 1 pF | | |
| C5, C6, | multilayer ceramic chip capacitor; note 1 | 1.5 pF | | |
| C11, C12,C13 | multilayer ceramic chip capacitor; note 1 | 10 nF | | |
| C14, C15 | electrolytic capacitor | 10 V; 470 μ F | | 2222 031 34471 |
| L1 | stripline; note 2 | | length 4 mm width 0.93 mm | |
| L2 | stripline; note 2 | | length 26 mm width 0.93 mm | |
| L3 | stripline; note 2 | | length 1.9 mm width 0.93 mm | |
| L4 | stripline; note 2 | | length 3.1 mm width 0.93 mm | |
| L5 | stripline; note 2 | | length 1.8 mm width 0.93 mm | |
| L6 | stripline; note 2 | | length 26.4 mm width 0.93 mm | |
| L7 | stripline; note 2 | | length 10 mm width 0.93 mm | |
| L8 | stripline; note 2 | | length 4.4 mm width 0.4 mm | |
| L9 | stripline; note 2 | | length 19.3 mm width 0.93 mm | |
| L10 | stripline; note 2 | | length 19.7 mm width 0.4 mm | |
| L11 | micro choke | | | |
| T1 | BD228 | | | |
| R1 | metal film resistor | 20 Ω ; 0.4 W | | 2322 157 10209 |
| R2 | metal film resistor | 265 Ω ; 0.4 W | | 2322 157 12651 |

Notes

1. American Technical Ceramics (ATC) capacitor, type 100A or other capacitor of the same quality.
2. The striplines are on a $\frac{1}{32}$ inch double copper-clad printed-circuit board with PTFE fibre-glass dielectric ($\epsilon_r = 6$).

NPN 2 GHz RF power transistor

BFG11; BFG11/X



Dimensions in mm.

The components are situated on one side of the copper-clad PTFE microfibre-glass board, the other side is not etched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.8 Printed-circuit board and component lay-out for common-emitter test circuit in Fig.7.

NPN 2 GHz power transistor

BFG11W/X

FEATURES

- High power gain
- High efficiency
- Small size discrete power amplifier
- 1.9 GHz operating area
- Gold metallization ensures excellent reliability
- Linear and non-linear operation.

APPLICATIONS

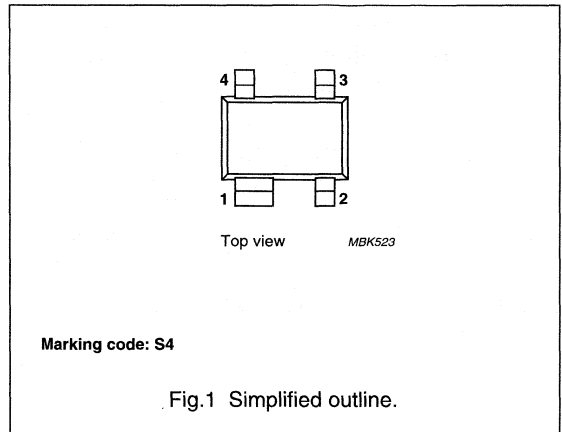
- Common emitter class-AB operation in handheld radio equipment at 1.9 GHz such as DECT, PHS.
- Driver for DCS 1800.

DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a plastic 4-pin dual-emitter SOT343 package.

PINNING - SOT343

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

RF performance at $T_s \leq 60^\circ\text{C}$ in a common-emitter test circuit.

| MODE OF OPERATION | f (GHz) | V_{CE} (V) | P_L (mW) | G_p (dB) | η_c (%) |
|---|---------|--------------|------------|------------|--------------|
| Pulsed, class-AB, $\delta < 1 : 2$; $t_p = 5$ ms | 1.9 | 3.6 | 400 | ≥ 6 | ≥ 60 |

NPN 2 GHz power transistor

BFG11W/X

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 500 | mA |
| P_{tot} | total power dissipation | up to $T_s = 60\text{ °C}$; note 1 | – | 760 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|--|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 60\text{ °C}$; $P_{tot} = 760\text{ mW}$; note 1 | 150 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector tab.

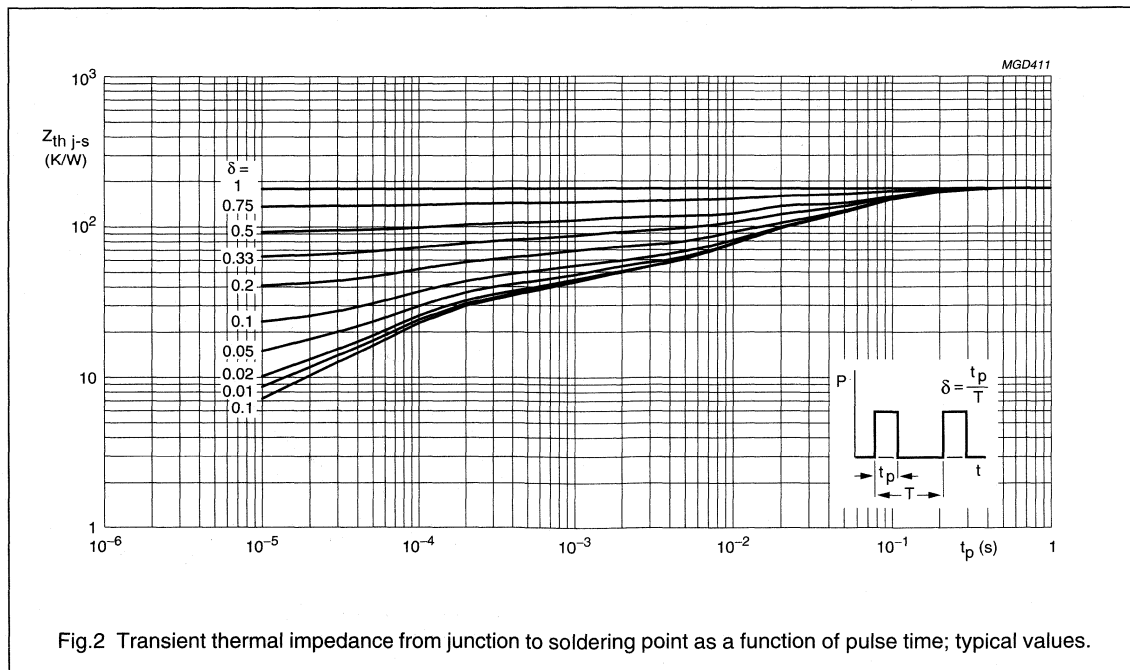


Fig.2 Transient thermal impedance from junction to soldering point as a function of pulse time; typical values.

NPN 2 GHz power transistor

BFG11W/X

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|---------------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 0.1\text{ mA}$; open emitter | 20 | — | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 10\text{ mA}$; open base | 8 | — | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 0.1\text{ mA}$; open collector | 2.5 | — | V |
| I_{CES} | collector cut-off current | $V_{CE} = 8\text{ V}$; $V_{BE} = 0$ | — | 100 | μA |
| h_{FE} | DC current gain | $V_{CE} = 5\text{ V}$; $I_C = 100\text{ mA}$ | 25 | — | |
| C_c | collector capacitance | $V_{CB} = 3.6\text{ V}$; $I_E = I_B = 0$; $f = 1\text{ MHz}$ | — | 5 | pF |
| C_{re} | feedback capacitance | $V_{CE} = 3.6\text{ V}$; $I_C = 0$; $f = 1\text{ MHz}$ | — | 4 | pF |

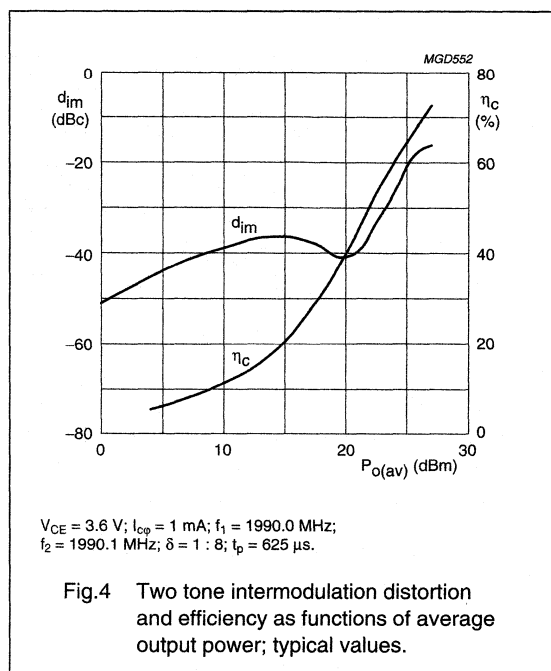
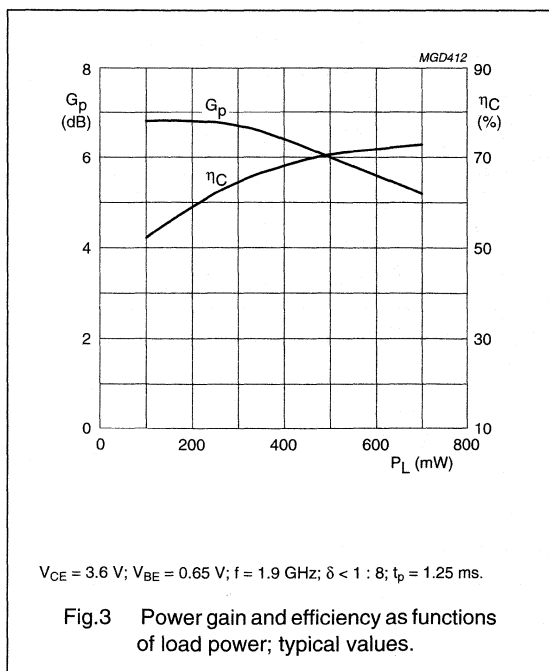
APPLICATION INFORMATION

RF performance at $T_s \leq 60\text{ }^\circ\text{C}$ in a common-emitter test circuit.

| MODE OF OPERATION | f (GHz) | V_{CE} (V) | I_{CQ} (mA) | P_L (mW) | G_p (dB) | η_c (%) |
|--|---------|--------------|---------------|------------|------------|--------------|
| Pulsed, class-AB, $\delta < 1 : 2$; $t_p = 5\text{ ms}$ | 1.9 | 3.6 | 1 | 400 | ≥ 6 | ≥ 60 |

Ruggedness in class-AB operation

The transistors are capable of withstanding a load mismatch corresponding to $V_{SWR} = 8 : 1$ through all phases, at rated output power under pulsed conditions at $f = 1.9\text{ GHz}$: $t_p = 1.25\text{ ms}$, $\delta = 1 : 8$ at $V_{CE} = 7\text{ V}$ and $t_p = 5\text{ ms}$, $\delta = 1 : 2$ at $V_{CE} = 4.5\text{ V}$.



NPN 2 GHz power transistor

BFG11W/X

List of components used in test circuit (see Figs 5 and 6)

| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE NO. |
|-----------------|---|-----------------------|--------------------------------|----------------|
| C1, C8, C9, C10 | multilayer ceramic chip capacitor; note 1 | 24 pF | | |
| C2, C3 | multilayer ceramic chip capacitor; note 1 | 2 pF | | |
| C4 | multilayer ceramic chip capacitor; note 1 | 1.2 pF | | |
| C5 | multilayer ceramic chip capacitor; note 1 | 0.2 pF | | |
| C6, C7, | multilayer ceramic chip capacitor; note 1 | 1.3 pF | | |
| C11, C12, C13 | multilayer ceramic chip capacitor; note 1 | 10 nF | | |
| C14, C15 | electrolytic capacitor | 470 μ F; 10 V | | 2222 032 14152 |
| L1 | stripline; note 2 | | length 22.5 mm width 0.9 mm | |
| L2 | stripline; note 2 | | length 6 mm width 0.9 mm | |
| L3 | stripline; note 2 | | length 1 mm width 0.9 mm | |
| L4 | stripline; note 2 | | length 2.5 mm width 0.9 mm | |
| L5 | stripline; note 2 | | length 4.5 mm width 0.9 mm | |
| L6 | stripline; note 2 | | length 24.5 mm width 0.9 mm | |
| L7 | stripline; note 2 | | length 20 mm width 0.9 mm | |
| L8 | stripline; note 2 | | length 10.5 mm width 0.9 mm | |
| L9 | stripline; note 2 | | length 4.4 mm width 0.4 mm | |
| L10 | stripline; note 2 | | length 19.7 mm width 0.4 mm | |
| L11, L12 | RF choke | 1 μ H | | 4330 030 36301 |
| R1 | metal film resistor | 78.7 Ω ; 0.4 W | | |
| R2 | metal film resistor | 38.3 Ω ; 0.4 W | | |
| R3 | metal film resistor | 10 Ω ; 0.4 W | | |
| T1 | bias transistor | BC548; note 3 | | |

Notes

- American Technical Ceramics (ATC) capacitor, type 100A or other capacitor of the same quality.
- The striplines are on a double copper-clad printed-circuit board with PTFE fibre-glass dielectric $\epsilon_r = 6.15$; $\tan \delta = 0.0019$; thickness = 0.64 mm; copper cladding = 35 μ m.
- Or equivalent ($V_{BE} = 0.65$ V at $T_{amb} = 25$ °C).

NPN 2 GHz power transistor

BFG11W/X

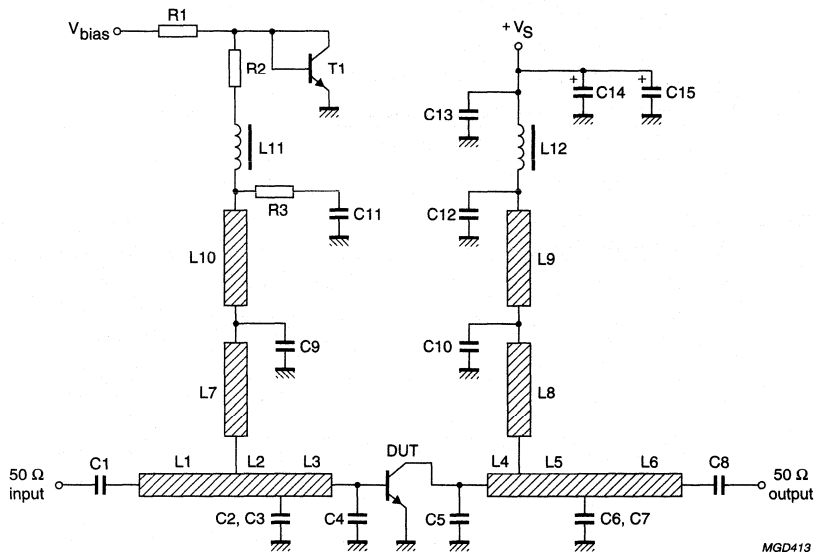
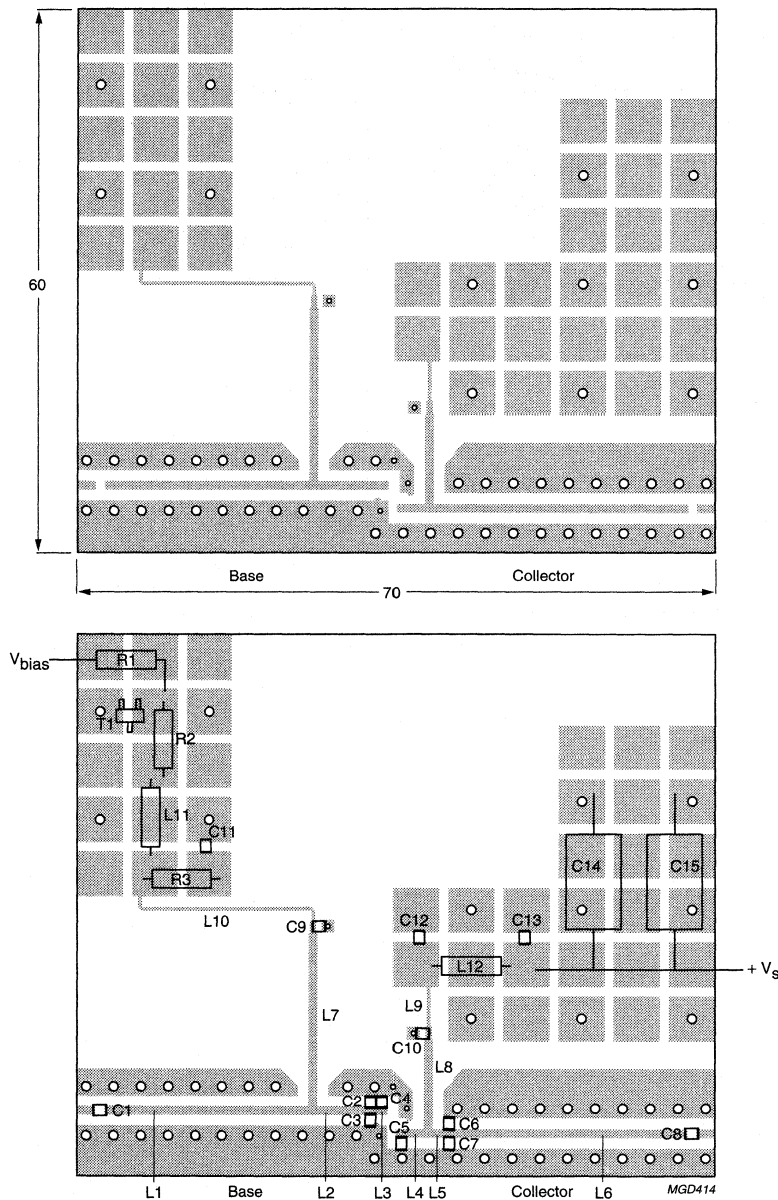


Fig.5 Common-emitter test circuit for class-AB operation at 1.9 GHz.

NPN 2 GHz power transistor

BFG11W/X

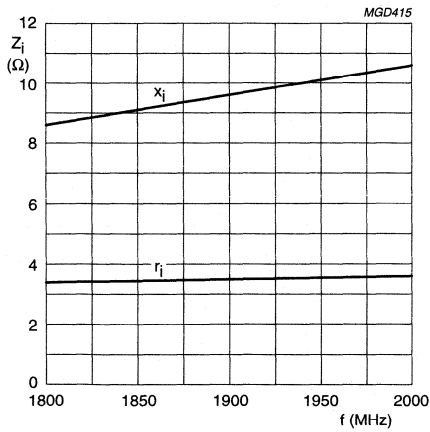


Dimensions in mm.

Fig.6 Component layout for common-emitter test circuit.

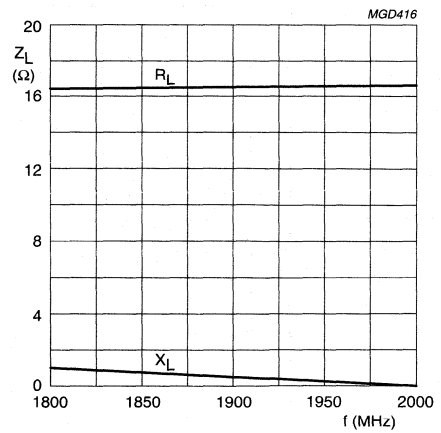
NPN 2 GHz power transistor

BFG11W/X



$V_{CE} = 3.6 \text{ V}; V_{BE} = 0.65 \text{ V}; P_L = 400 \text{ mW}.$

Fig.7 Input impedance as a function of frequency (series components), typical values.



$V_{CE} = 3.6 \text{ V}; V_{BE} = 0.65 \text{ V}; P_L = 400 \text{ mW}.$

Fig.8 Load impedance as a function of frequency (series components), typical values.

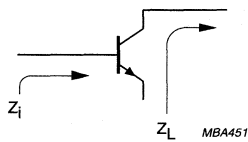


Fig.9 Definition of transistor impedance.

NPN 2 GHz wideband transistor

BFG16A

FEATURES

- High power gain
- Good thermal stability
- Gold metallization ensures excellent reliability.

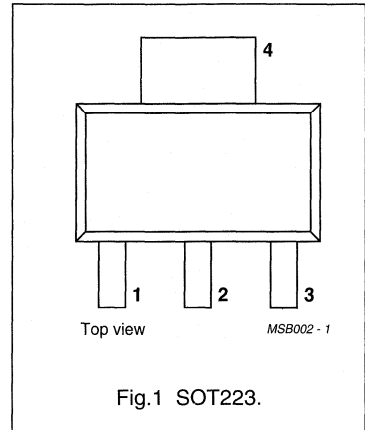
DESCRIPTION

NPN transistor mounted in a plastic SOT223 envelope.

It is primarily intended for use in wideband amplifiers, aerial amplifiers and vertical amplifiers in high speed oscilloscopes.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 40 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 25 | V |
| I_C | DC collector current | | – | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 110\text{ }^\circ\text{C}$; note 1 | – | – | 1 | W |
| h_{FE} | DC current gain | $I_C = 150\text{ mA}$; $V_{CE} = 5\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$ | 25 | 80 | – | |
| f_T | transition frequency | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1.5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 10 | – | dB |

Note

1. T_s is the temperature at the soldering point of the collector tab.

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 40 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 110\text{ }^\circ\text{C}$; note 1 | – | 1 | W |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 150 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 2 GHz wideband transistor

BFG16A

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|--------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 110\text{ °C}$; note 1 | 40 | K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

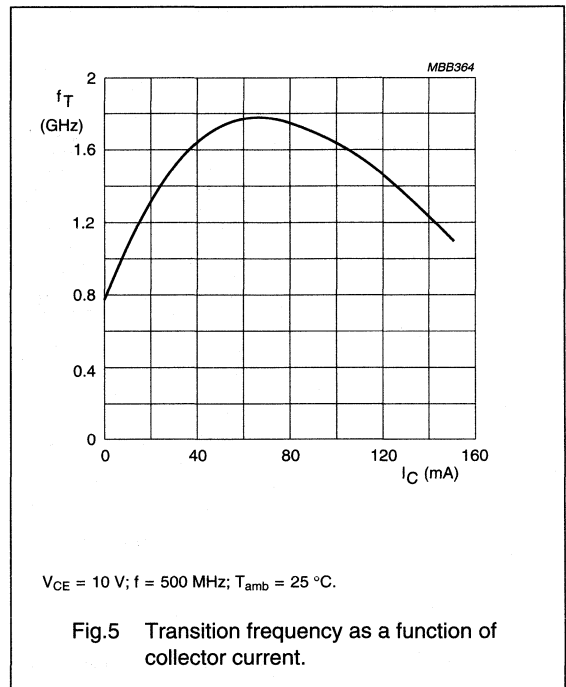
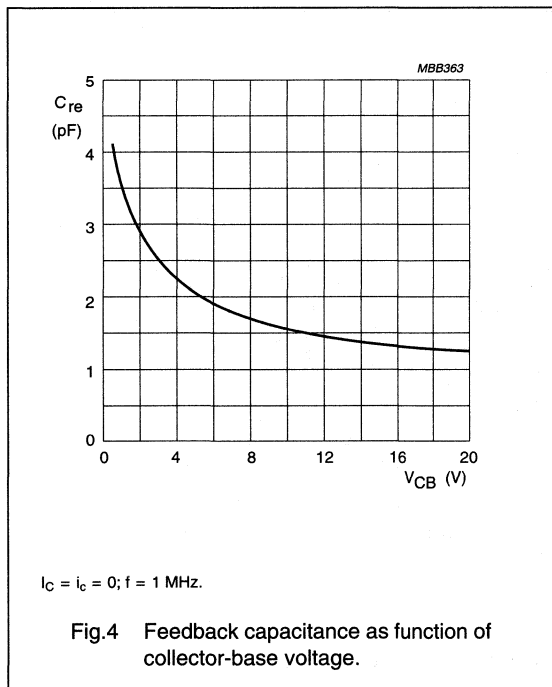
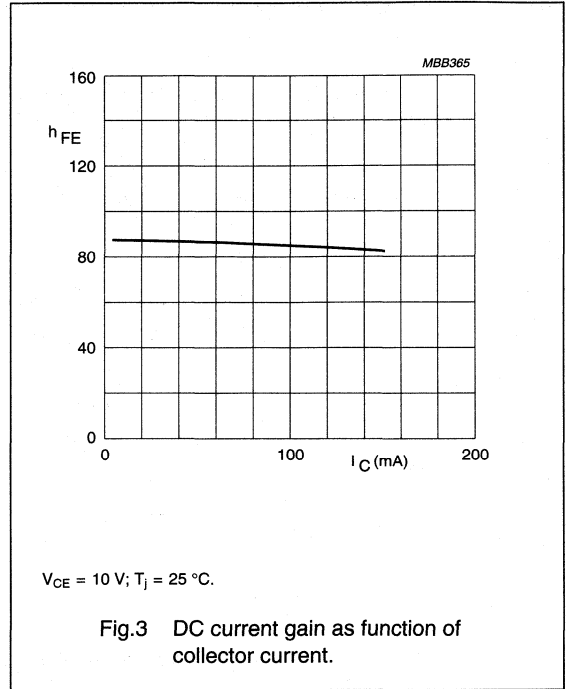
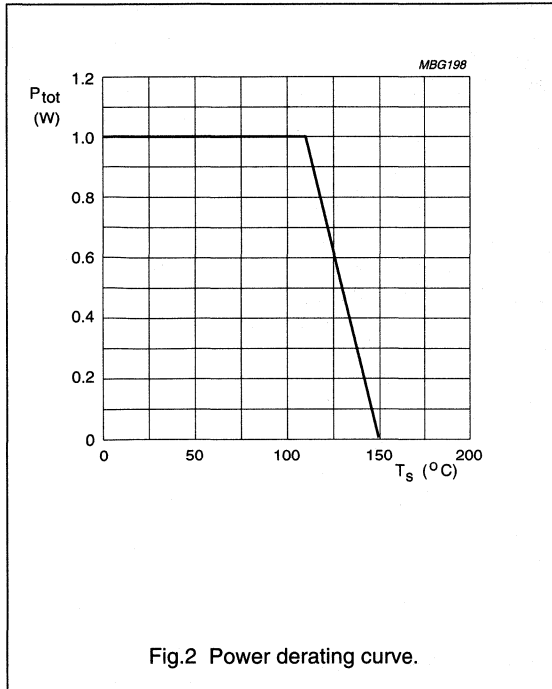
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---|---|------|------|------|---------------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 0.1\text{ mA}$ | 25 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 10\text{ mA}$ | 18 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.1\text{ mA}$ | 3 | – | – | V |
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 28\text{ V}$ | – | – | 20 | μA |
| h_{FE} | DC current gain | $I_C = 150\text{ mA}$; $V_{CE} = 5\text{ V}$ | 25 | 80 | – | |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 2.5 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 10.0 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 1.5 | – | pF |
| f_T | transition frequency | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.5 | – | GHz |
| G_{UM} | maximum unilateral power gain note 1 | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 10 | – | dB |

Note

- G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

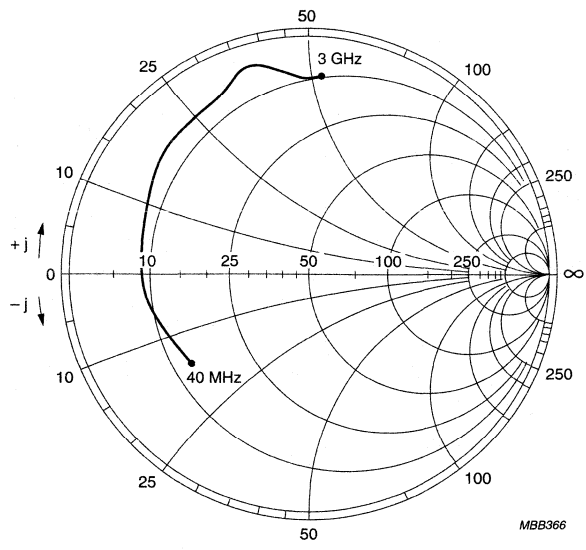
NPN 2 GHz wideband transistor

BFG16A



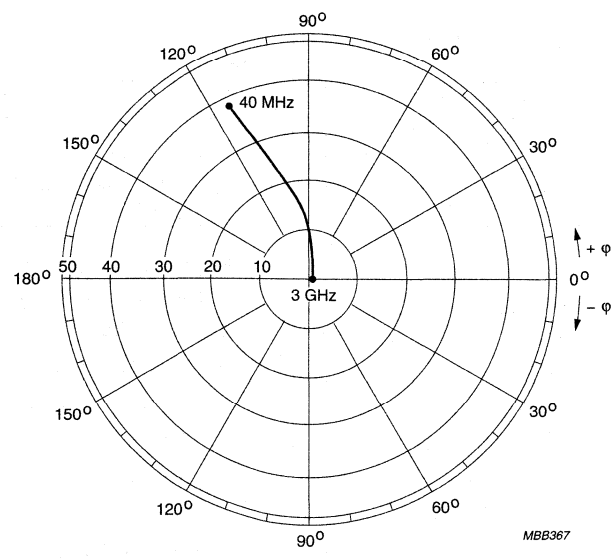
NPN 2 GHz wideband transistor

BFG16A



$I_C = 70 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $Z_0 = 50 \Omega$.

Fig.6 Common emitter input reflection coefficient (S_{11}).

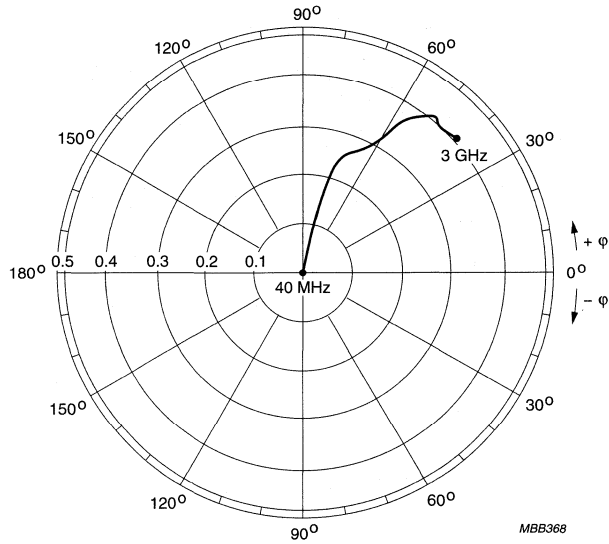


$I_C = 70 \text{ mA}$; $V_{CE} = 15 \text{ V}$.

Fig.7 Common emitter forward transmission coefficient (S_{21}).

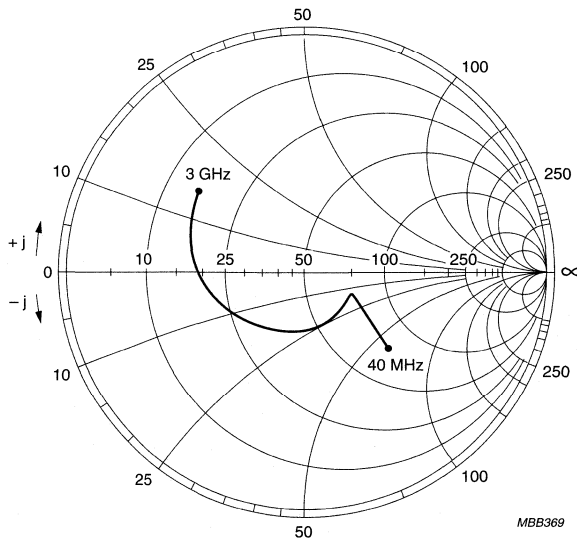
NPN 2 GHz wideband transistor

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$I_C = 70 \text{ mA}; V_{CE} = 15 \text{ V}.$

Fig.8 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 70 \text{ mA}; V_{CE} = 15 \text{ V}; Z_0 = 50 \Omega.$

Fig.9 Common emitter output transmission coefficient (S_{22}).

NPN 3 GHz wideband transistor

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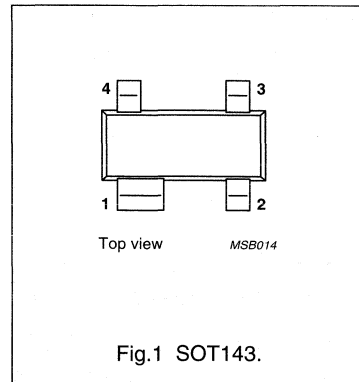
DESCRIPTION

NPN wideband transistor in a microminiature plastic SOT143 surface mounting envelope with double emitter bonding.

It is intended for use in wideband aerial amplifiers using SMD technology.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: E6 | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | DC collector current | | – | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ °C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = 25\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ °C}$ | 20 | – | 150 | |
| f_T | transition frequency | $I_C = 25\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 2.8 | – | GHz |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| G_{UM} | maximum unilateral power gain | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$; $Z_S = 60\text{ }\Omega$; $b_s = \text{opt.}$ | – | 2.5 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ °C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 3 GHz wideband transistor

BFG17A

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|-------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 85\text{ °C}$; note 1 | 290 | K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

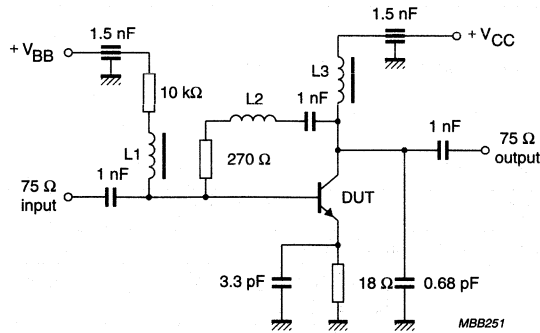
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 25\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ °C}$ | 20 | 75 | 150 | |
| f_T | transition frequency | $I_C = 25\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 2.8 | – | GHz |
| C_c | collector capacitance | $I_E = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 0.7 | – | pF |
| C_e | emitter capacitance | $I_C = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.25 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$; $Z_S = 60\text{ }\Omega$; $b_s = \text{opt.}$ | – | 2.5 | – | dB |
| V_o | output voltage | note 2 | – | 150 | – | mV |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB..
- $d_{im} = -60\text{ dB}$ (DIN 45004B, para. 6,3: 3-tone); $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $Z_L = 75\text{ }\Omega$.
 $V_p = V_o$; $f_p = 795.25\text{ MHz}$;
 $V_q = V_o - 6\text{ dB}$; $f_q = 803.25\text{ MHz}$;
 $V_r = V_o - 6\text{ dB}$; $f_r = 805.25\text{ MHz}$;
measured at $f_{(p+q-r)} = 793.25\text{ MHz}$.

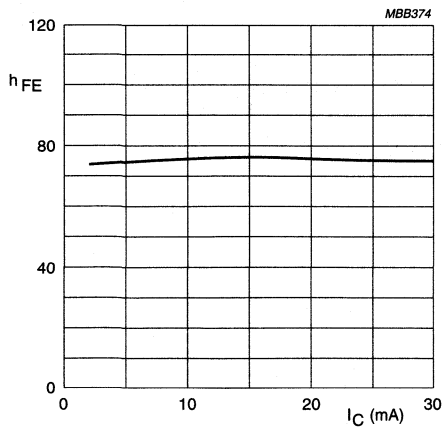
NPN 3 GHz wideband transistor

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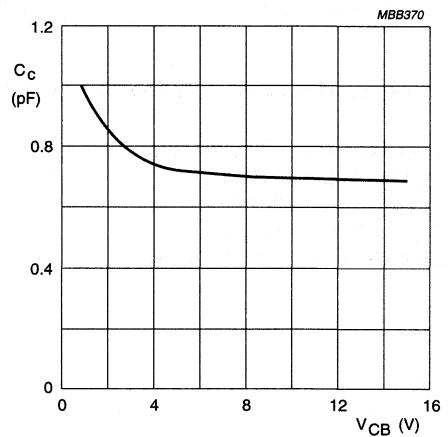
- (1) L1 = L3 = 5 μH Ferroxcube choke.
- (2) L2 = 3 turns 0.4 mm copper wire, internal diameter 3 mm, winding pitch 1 mm.

Fig.2 Intermodulation distortion and second order intermodulation distortion MATV test circuit.



$V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}.$

Fig.3 DC current gain as function of collector current.

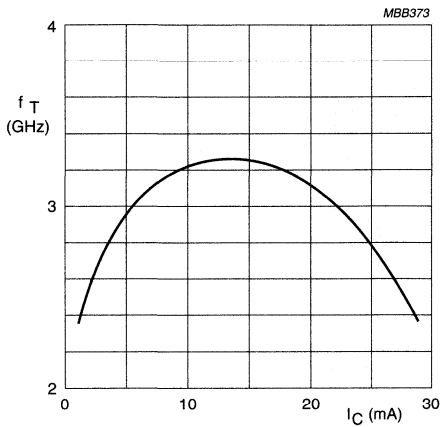


$I_E = 0; f = 1 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$

Fig.4 Collector capacitance as a function of collector-base voltage.

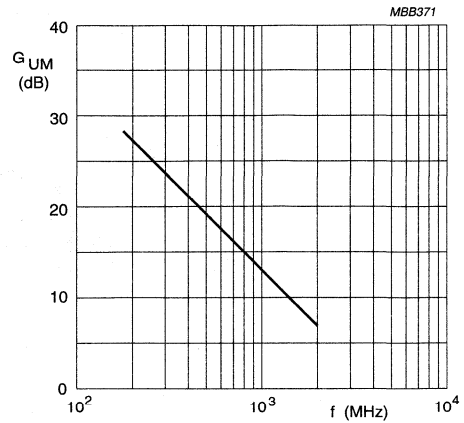
NPN 3 GHz wideband transistor

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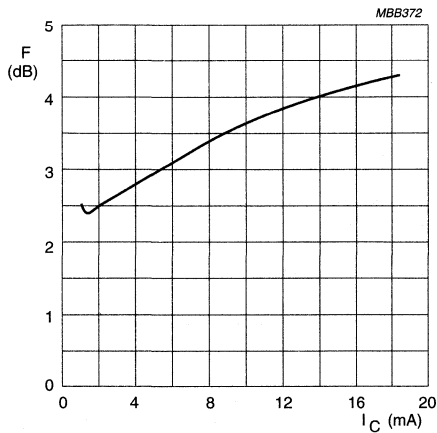
$V_{CE} = 5$ V; $f = 500$ MHz; $T_{amb} = 25$ °C.

Fig.5 Transition frequency as a function of collector current.



$I_C = 15$ mA; $V_{CE} = 10$ V; $T_{amb} = 25$ °C.

Fig.6 Maximum unilateral power gain as a function of frequency.

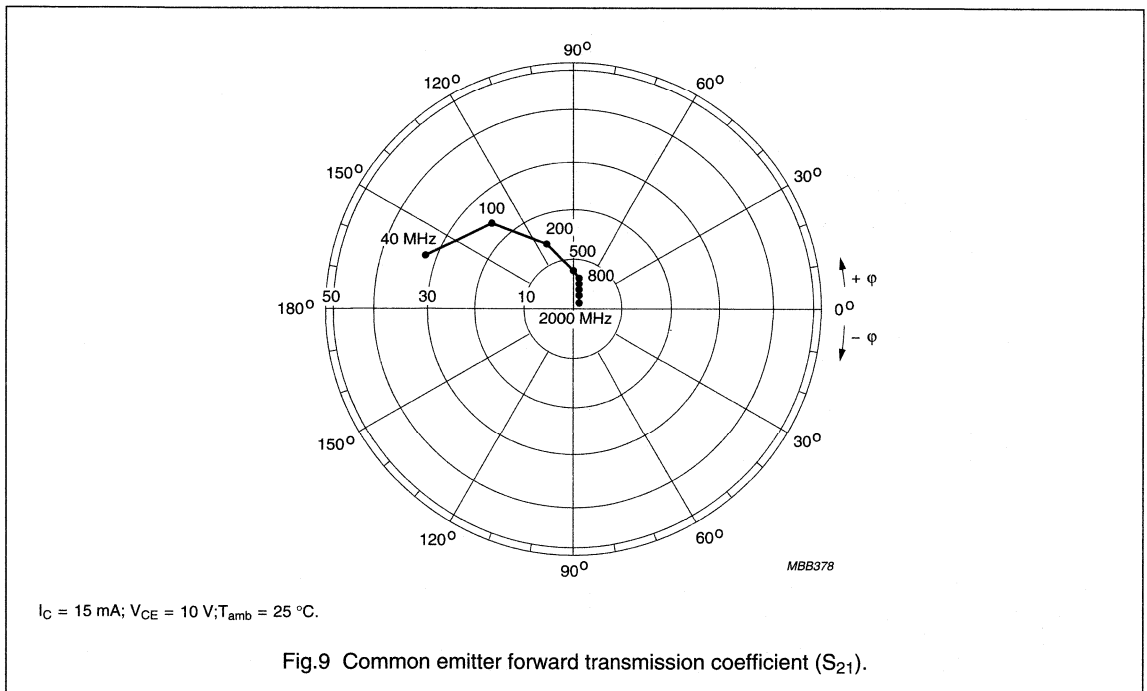
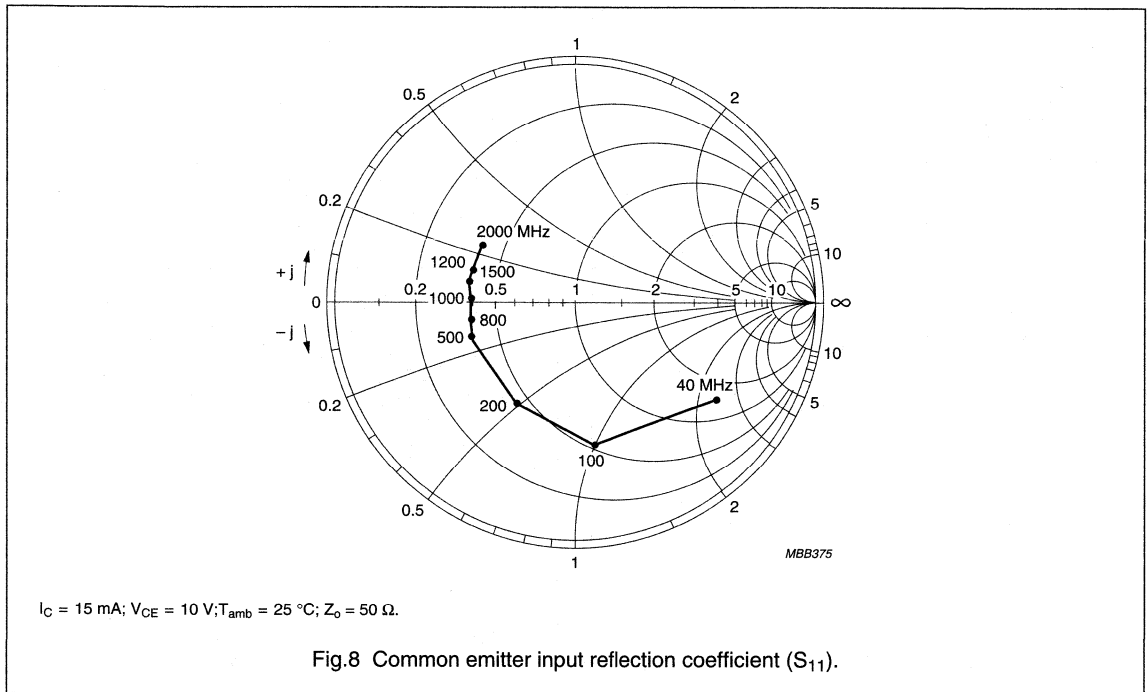


$V_{CE} = 5$ V; $f = 800$ MHz; $T_{amb} = 25$ °C; $Z_S = 60$ Ω ; $b_s = opt.$

Fig.7 Minimum noise figure as a function of collector current.

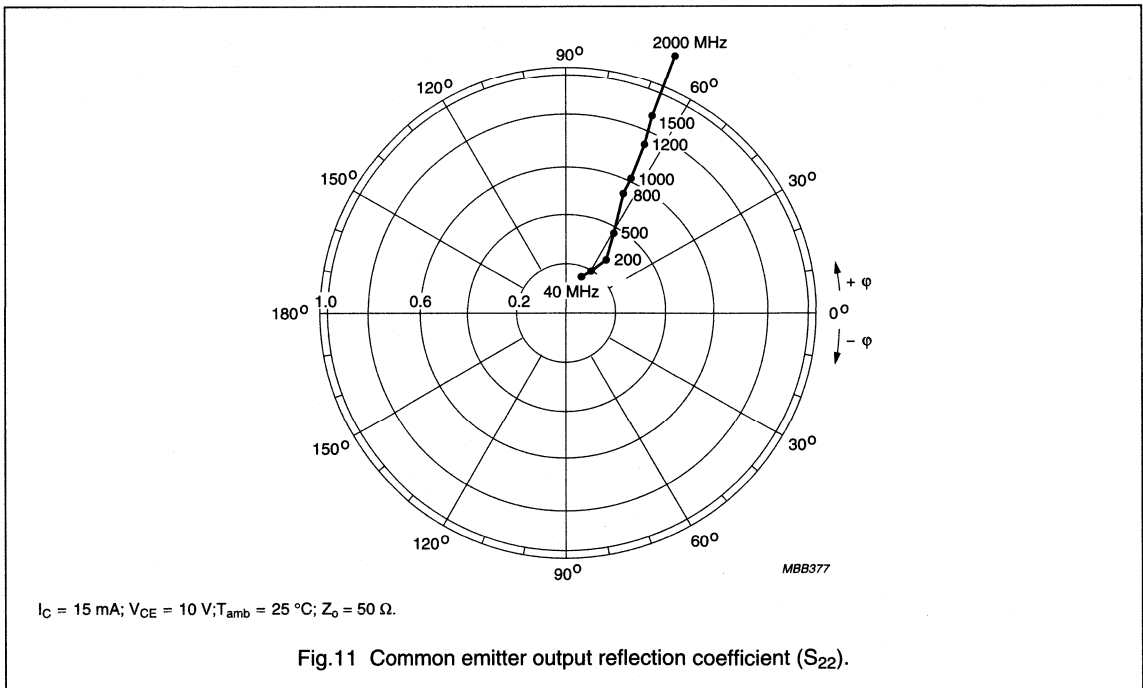
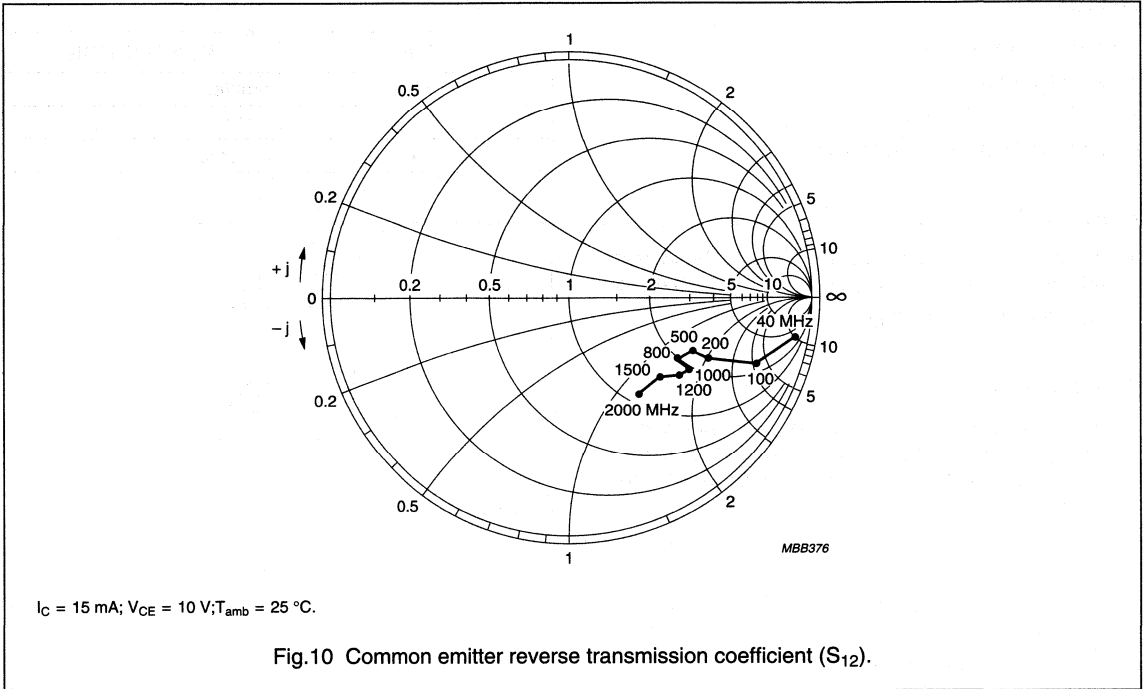
NPN 3 GHz wideband transistor

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NPN 3 GHz wideband transistor

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UHF power transistor

BFG21W

FEATURES

- High power gain
- High efficiency
- 1.9 GHz operating area
- Linear and non-linear operation.

APPLICATIONS

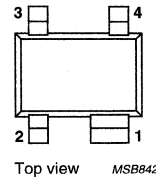
- Common emitter class-AB output stage in hand held radio equipment at 1.9 GHz such as DECT, PHS, etc.
- Driver for DCS1800, 1900.

DESCRIPTION

NPN double polysilicon bipolar power transistor with buried layer for low voltage medium power applications encapsulated in a plastic, 4-pin dual-emitter SOT343R package.

PINNING

| PIN | DESCRIPTION |
|------|-------------|
| 1, 3 | emitter |
| 2 | base |
| 4 | collector |



Marking code: P1.

Fig.1 Simplified outline SOT343R.

QUICK REFERENCE DATA

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit.

| MODE OF OPERATION | f (GHz) | V_{CE} (V) | P_L (mW) | G_p (dB) | η_c (%) |
|--|------------|-----------------|---------------|---------------|-----------------|
| Pulsed class-AB; $\delta < 1 : 2$; $t_p = 5$ ms | 1.9 | 3.6 | 400 | ≥ 10 | ≥ 55 |

PRELIMINARY
See Philips Semiconductors for Design-in information

UHF power transistor

BFG21W

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 15.5 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 4.5 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 1 | V |
| I_C | collector current (DC) | | – | 500 | mA |
| P_{tot} | total power dissipation | $T_s \leq 60\text{ }^\circ\text{C}$; note 1 | – | 600 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | operating junction temperature | | – | 150 | $^\circ\text{C}$ |

Note

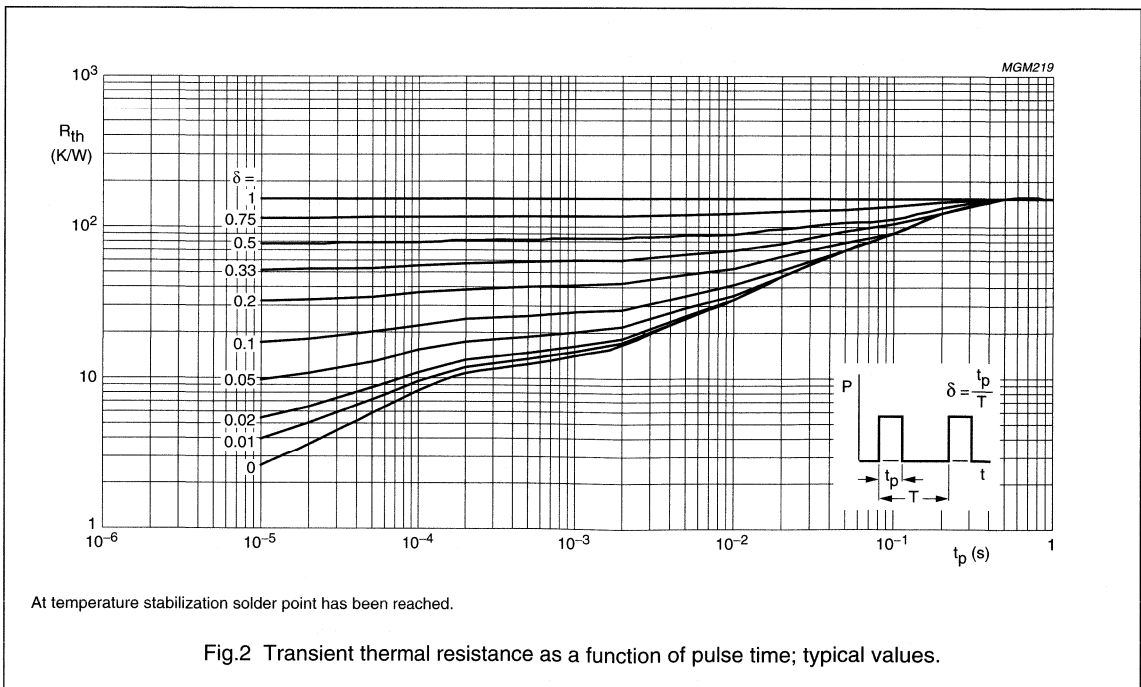
- T_s is the temperature at the soldering point of the emitter pins.

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|--|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | $T_s \leq 60\text{ }^\circ\text{C}$; $P_{tot} = 600\text{ mW}$; note 1 | 150 | K/W |

Note

- T_s is the temperature at the soldering point of the emitter pins.



UHF power transistor

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CHARACTERISTICS

$T_j = 25^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|-------------------------------------|---|------|------|---------------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 0.1\text{ mA}$ | 15.5 | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 10\text{ mA}$ | 4.5 | – | V |
| $V_{(BR)CER}$ | collector-emitter breakdown voltage | $R_{BE} < 1\text{ k}\Omega$, $I_C = 10\text{ mA}$ | 10 | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.1\text{ mA}$ | 1 | – | V |
| I_{CES} | collector leakage current | $V_{CE} = 5\text{ V}$; $V_{BE} = 0$ | – | 10 | μA |
| h_{FE} | DC current gain | $I_C = 200\text{ mA}$; $V_{CE} = 2\text{ V}$ | 40 | 100 | |
| C_C | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 3\text{ V}$; $f = 1\text{ MHz}$ | – | 3 | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 3.6\text{ V}$; $f = 1\text{ MHz}$ | – | 1.5 | pF |
| f_T | transition frequency | $I_C = 200\text{ mA}$; $V_{CE} = 3.6\text{ V}$; $f = 700\text{ MHz}$ | 18 | – | GHz |

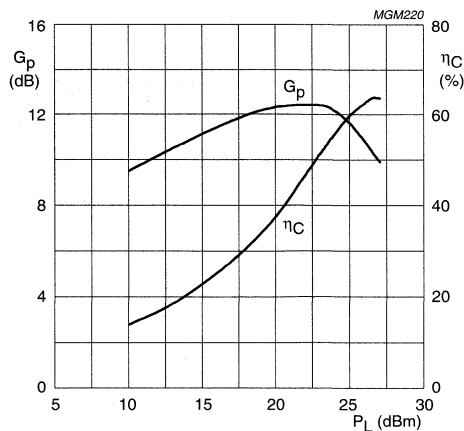
APPLICATION INFORMATION

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit (see Figs 4 and 5).

| MODE OF OPERATION | f (GHz) | V_{CE} (V) | I_{CQ} (mA) | P_L (mW) | G_p (dB) | η_C (%) |
|--|---------|--------------|---------------|------------|------------|--------------|
| Pulsed; class-AB; $\delta < 1 : 2$; $t_p = 5\text{ ms}$ | 1.9 | 3.6 | 1 | 400 | ≥ 10 | ≥ 55 |

Ruggedness in class-AB operation

The transistor is capable of withstanding a load mismatch corresponding to $V_{SWR} = 6 : 1$ through all phases at rated output power under pulsed conditions: $\delta = 1 : 2$; $t_p = 5\text{ ms}$; $f = 1.9\text{ GHz}$ at $V_{CE} = 4.5\text{ V}$.



Pulsed, class-AB operation; $\delta < 1 : 2$; $t_p = 5\text{ ms}$.
 $f = 1.9\text{ GHz}$; $V_{CE} = 3.6\text{ V}$; $I_{CQ} = 1\text{ mA}$; tuned at $P_L = 400\text{ mW}$.

Fig.3 Power gain and collector efficiency as a function of the load power; typical values.

UHF power transistor

BFG21W

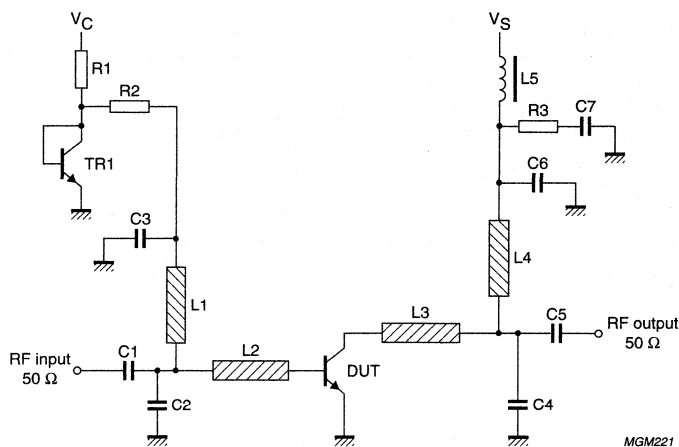


Fig.4 Common emitter test circuit for class-AB operation at 1.9 GHz.

List of components used in test circuit (see Figs 4 and 5)

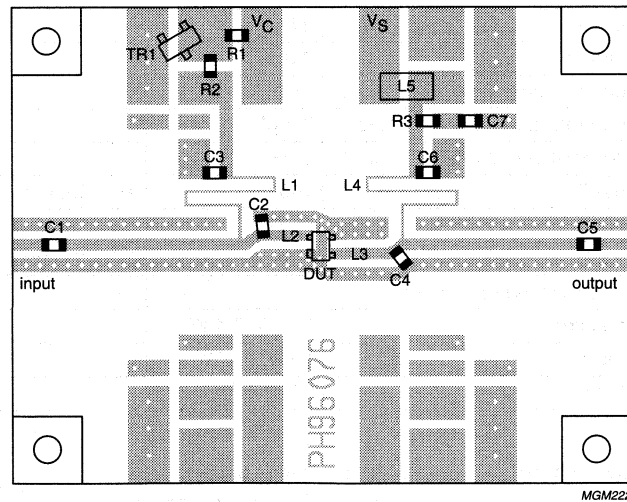
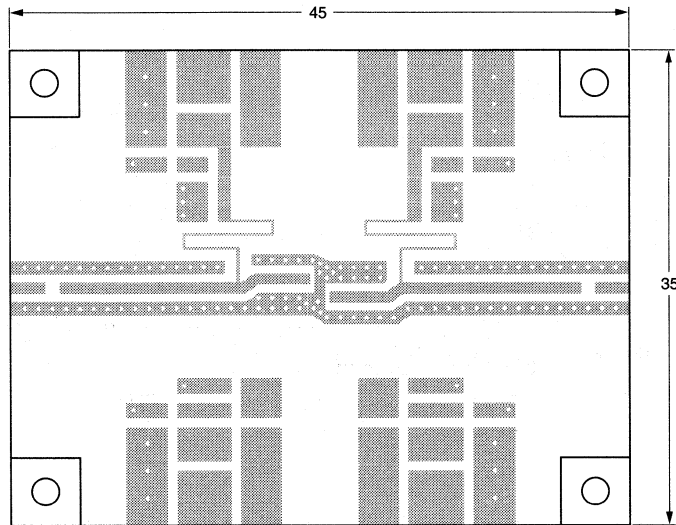
| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE No. |
|-----------|---|--------------|--------------|----------------|
| C1, C5 | multilayer ceramic chip capacitor; note 1 | 24 pF | | |
| C2 | multilayer ceramic chip capacitor; note 1 | 3.3 pF | | |
| C3, C6 | multilayer ceramic chip capacitor; note 1 | 15 pF | | |
| C4 | multilayer ceramic chip capacitor; note 1 | 2.4 pF | | |
| C7 | multilayer ceramic chip capacitor; note 1 | 1 nF | | |
| L1, L4 | stripline; note 2 | 100 Ω | 18 x 0.2 mm | |
| L2 | stripline; note 2 | 50 Ω | 3.2 x 0.8 mm | |
| L3 | stripline; note 2 | 50 Ω | 4.6 x 0.8 mm | |
| L5 | Grade 4S2 Ferroxcube chip bead | | | 4330 030 36300 |
| R1 | metal film resistor | 220 Ω; 0.4 W | | |
| R2, R3 | metal film resistor | 10 Ω; 0.4 W | | |
| TR1 | NPN transistor | BC817 | | 9335 895 20215 |

Notes

- American Technical Ceramics type 100A or capacitor of same quality.
- The striplines are on a double copper-clad printed-circuit board with PTFE fibre-glass dielectric ($\epsilon_r = 6.15$, $\tan \delta = 0.0019$); thickness 0.64 mm, copper cladding = 35 μm .

UHF power transistor

BFG21W



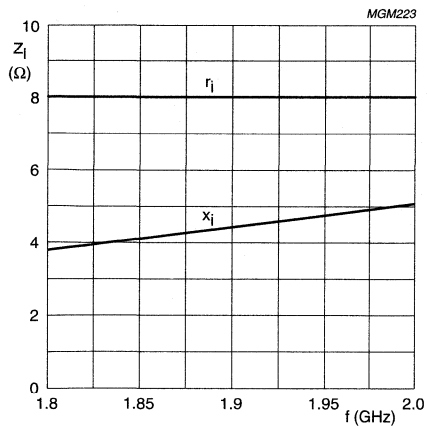
Dimensions in mm.

The components are situated on one side of the copper-clad PTFE fibre-glass board, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.5 Printed-circuit board and component lay-out for 1.9 GHz class-AB test circuit in Fig.4.

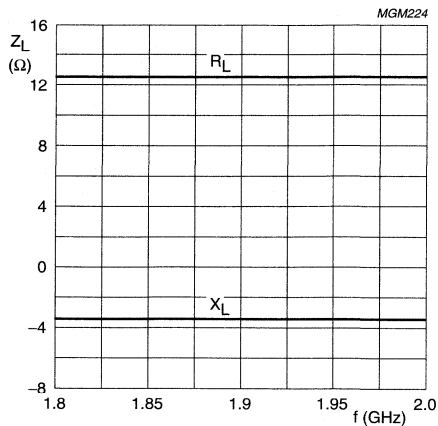
UHF power transistor

BFG21W



$V_{CE} = 3.6 \text{ V}$; $I_{CQ} = 1 \text{ mA}$; $P_L = 400 \text{ mW}$; $T_s \leq 60 \text{ }^\circ\text{C}$.

Fig. 6 Input impedance as function of frequency (series components); typical values.



$V_{CE} = 3.6 \text{ V}$; $I_{CQ} = 1 \text{ mA}$; $P_L = 400 \text{ mW}$; $T_s \leq 60 \text{ }^\circ\text{C}$.

Fig. 7 Load impedance as a function of frequency (series components); typical values.

NPN 5 GHz wideband transistor

BFG25A/X

FEATURES

- Low current consumption (100 μ A to 1 mA)
- Low noise figure
- Gold metallization ensures excellent reliability.

APPLICATIONS

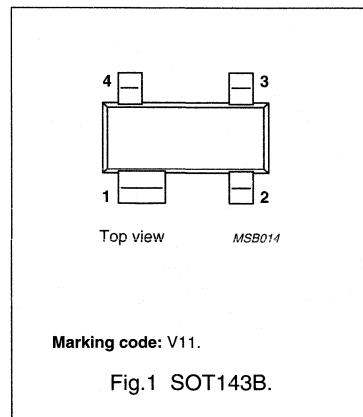
- RF low power amplifiers, such as pocket telephones, paging systems, with signal frequencies up to 2 GHz.

DESCRIPTION

NPN silicon wideband transistor in a four-lead dual emitter SOT143B plastic package (cross emitter).

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | | – | – | 8 | V |
| V_{CEO} | collector-emitter voltage | | – | – | 5 | V |
| I_C | collector current (DC) | | – | – | 6.5 | mA |
| P_{tot} | total power dissipation | $T_s \leq 165\text{ }^\circ\text{C}$ | – | – | 32 | mW |
| h_{FE} | DC current gain | $I_C = 0.5\text{ mA}; V_{CE} = 1\text{ V}$ | 50 | 80 | 200 | |
| f_T | transition frequency | $I_C = 1\text{ mA}; V_{CE} = 1\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 0.5\text{ mA}; V_{CE} = 1\text{ V};$ $f = 1\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 18 | – | dB |
| F | noise figure | $I_C = 0.5\text{ mA}; V_{CE} = 1\text{ V};$ $f = 1\text{ GHz}; \Gamma = \Gamma_{opt}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1.8 | – | dB |
| | | $I_C = 1\text{ mA}; V_{CE} = 1\text{ V}; f = 1\text{ GHz};$ $\Gamma = \Gamma_{opt}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 2 | – | dB |

NPN 5 GHz wideband transistor

BFG25A/X

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-----------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 8 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 5 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | collector current (DC) | | – | 6.5 | mA |
| P_{tot} | total power dissipation | $T_s \leq 165\text{ °C}$; note 1 | – | 32 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector pin.

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | note 1 | 320 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS $T_j = 25\text{ °C}$ unless otherwise specified.

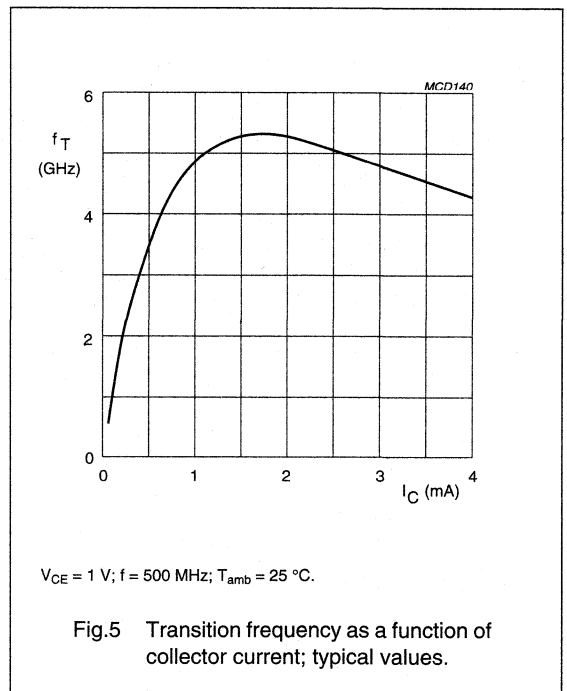
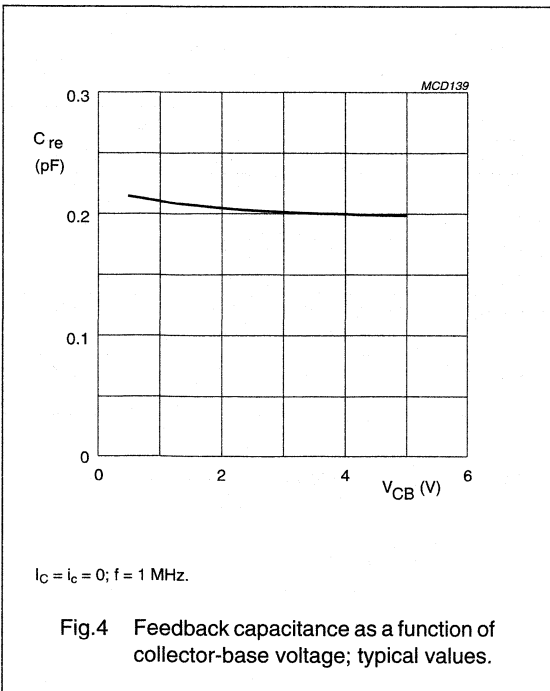
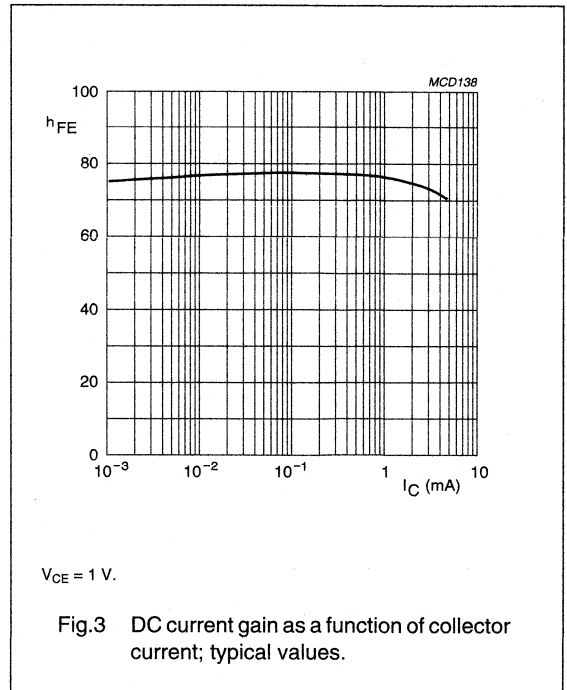
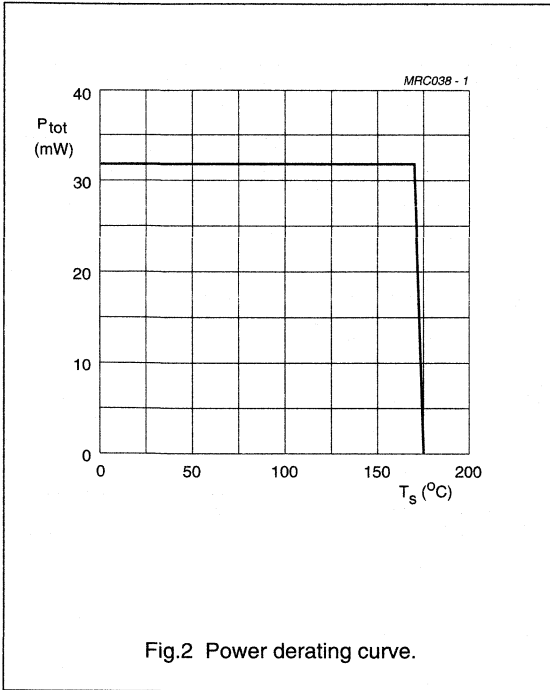
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--|------|------|------|---------------|
| I_{CBO} | collector leakage current | $I_E = 0$; $V_{CB} = 5\text{ V}$ | – | – | 50 | μA |
| h_{FE} | DC current gain | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$ | 50 | 80 | 200 | |
| C_{re} | feedback capacitance | $I_C = i_c = 0$; $V_{CB} = 1\text{ V}$; $f = 1\text{ MHz}$ | – | 0.21 | 0.3 | pF |
| f_T | transition frequency | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 500\text{ MHz}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 18 | – | dB |
| F | noise figure | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $\Gamma = \Gamma_{opt}$; $T_{amb} = 25\text{ °C}$ | – | 1.8 | – | dB |
| | | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $\Gamma = \Gamma_{opt}$; $T_{amb} = 25\text{ °C}$ | – | 2 | – | dB |

Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB

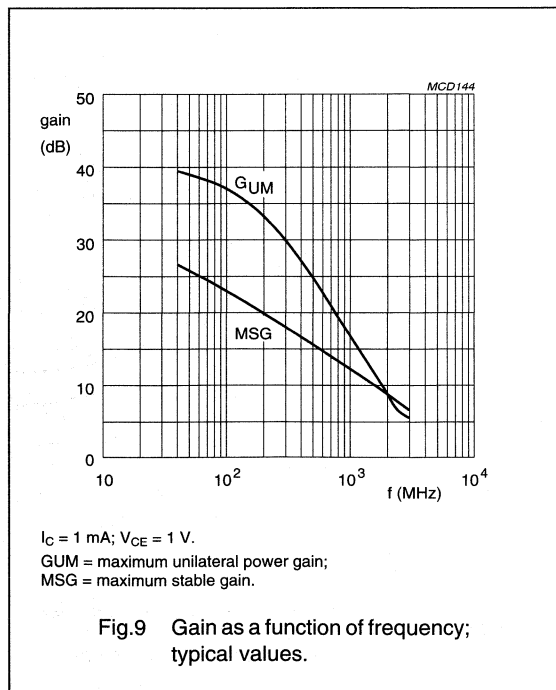
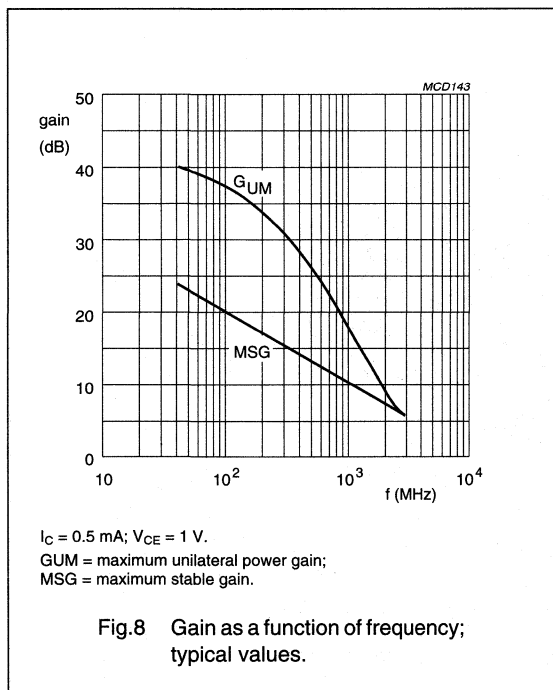
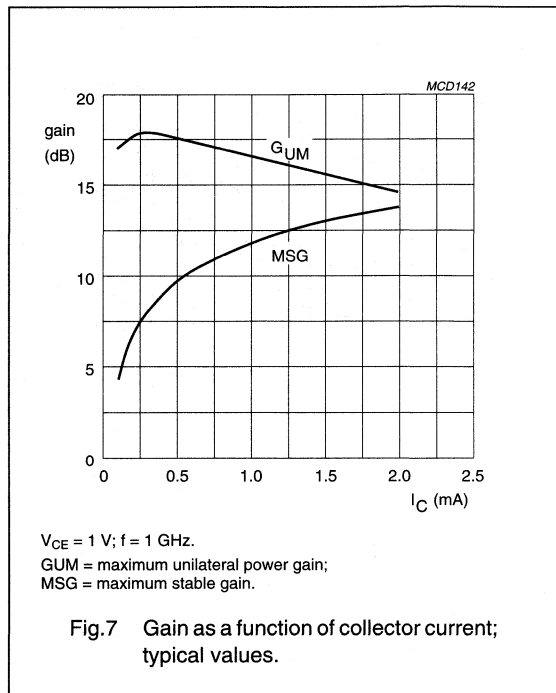
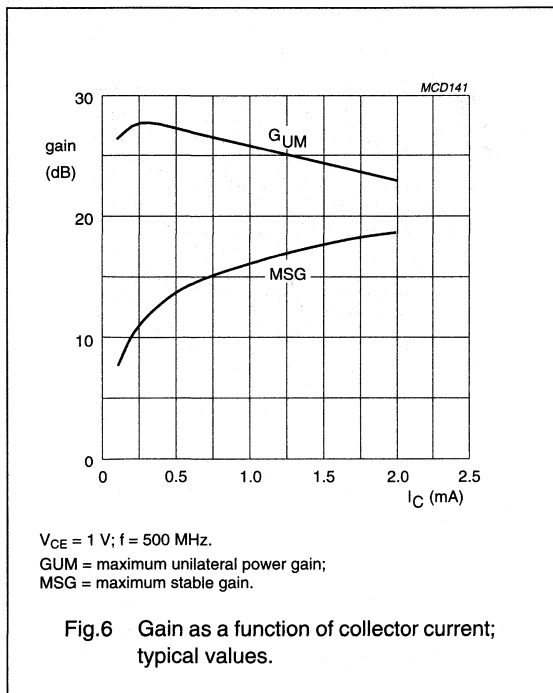
NPN 5 GHz wideband transistor

BFG25A/X



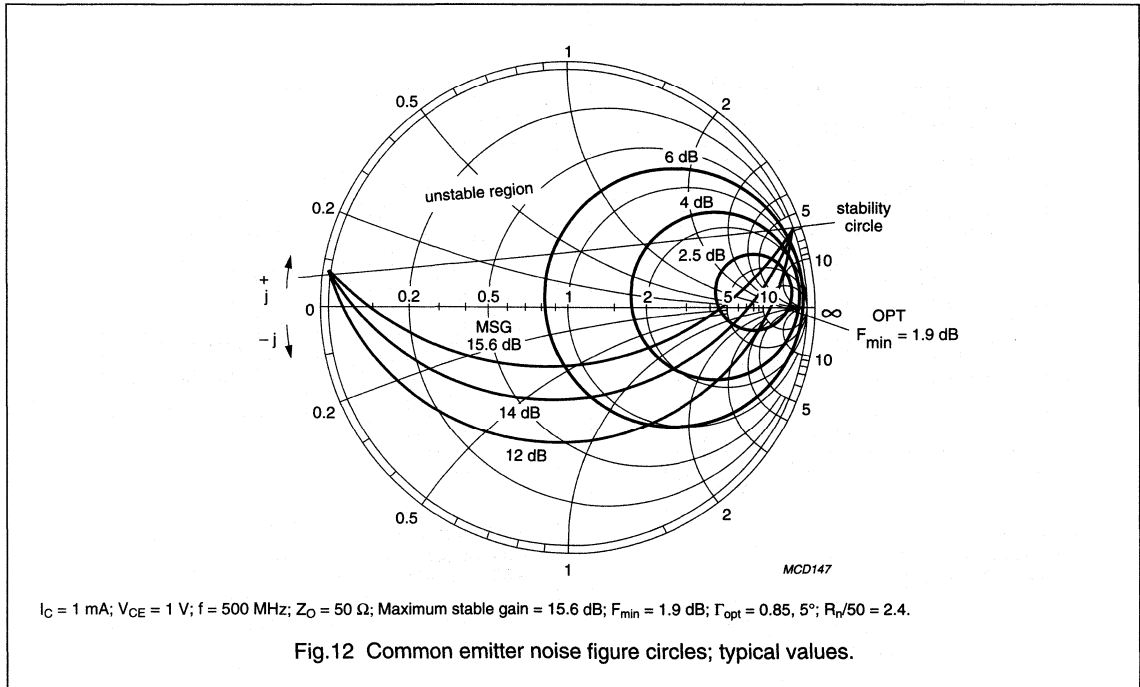
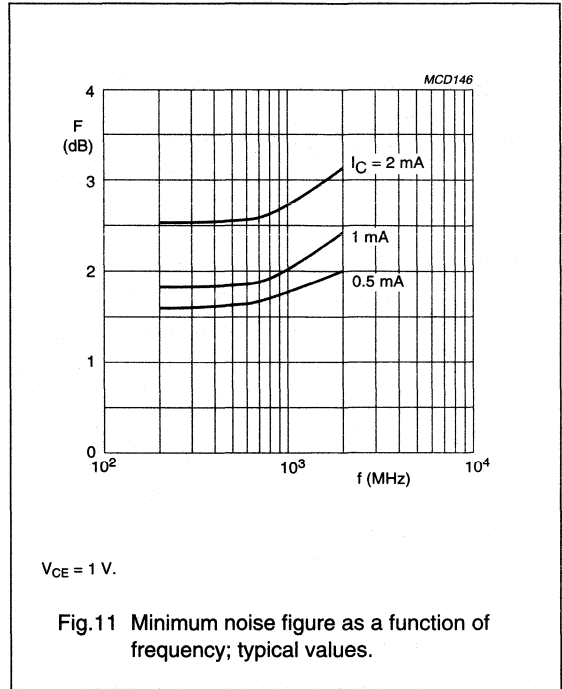
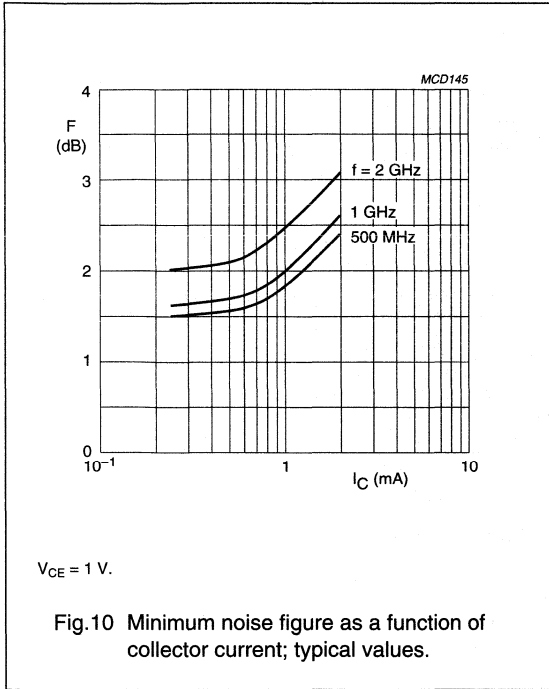
NPN 5 GHz wideband transistor

BFG25A/X



NPN 5 GHz wideband transistor

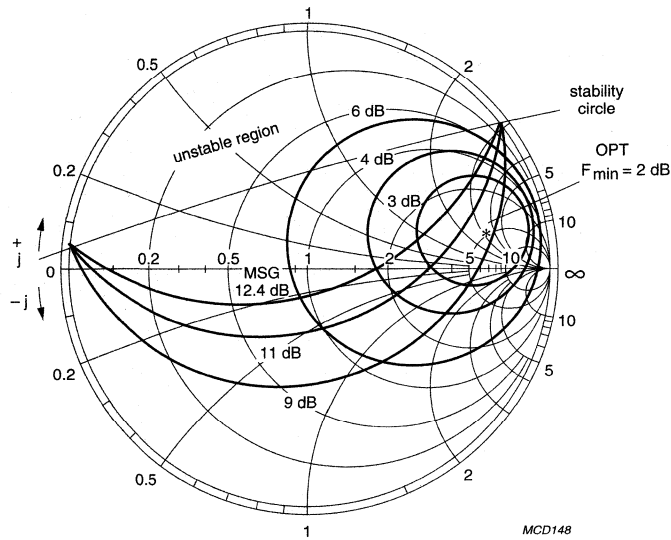
BFG25A/X



$I_C = 1 \text{ mA}$; $V_{CE} = 1 \text{ V}$; $f = 500 \text{ MHz}$; $Z_0 = 50 \Omega$; Maximum stable gain = 15.6 dB; $F_{min} = 1.9 \text{ dB}$; $\Gamma_{opt} = 0.85, 5^\circ$; $R_r/50 = 2.4$.

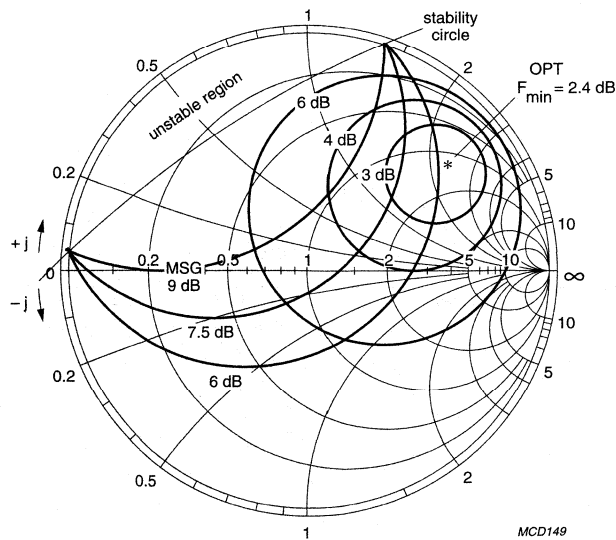
NPN 5 GHz wideband transistor

BFG25A/X



$I_C = 1 \text{ mA}$; $V_{CE} = 1 \text{ V}$; $f = 1000 \text{ MHz}$; $Z_O = 50 \Omega$; Maximum stable gain = 12.4 dB; $F_{\min} = 2 \text{ dB}$; $\Gamma_{\text{opt}} = 0.78, 14^\circ$; $R_r/50 = 2.6$.

Fig.13 Common emitter noise figure circles; typical values.

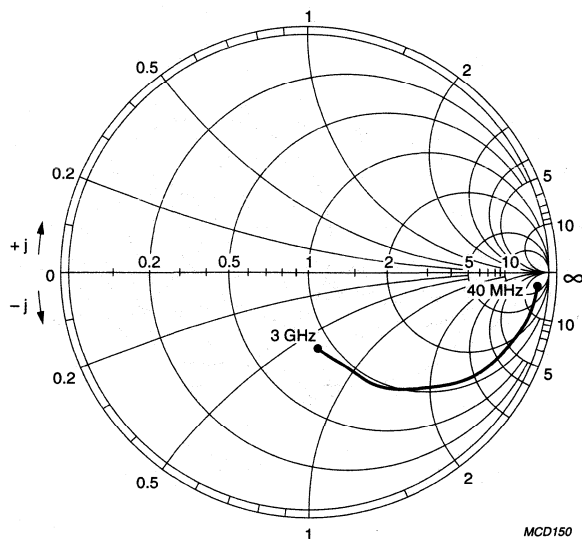


$I_C = 1 \text{ mA}$; $V_{CE} = 1 \text{ V}$; $f = 2000 \text{ MHz}$; $Z_O = 50 \Omega$; Maximum stable gain = 8.9 dB; $F_{\min} = 2.4 \text{ dB}$; $\Gamma_{\text{opt}} = 0.72, 38^\circ$; $R_r/50 = 1.9$.

Fig.14 Common emitter noise figure circles; typical values.

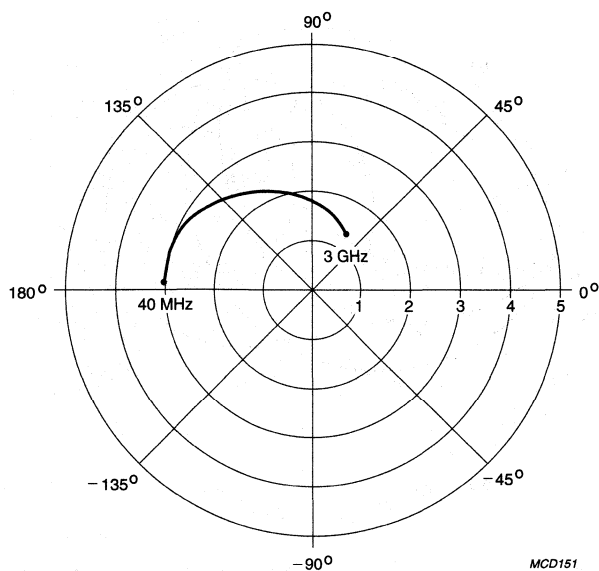
NPN 5 GHz wideband transistor

BFG25A/X



$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; Z_0 = 50 \Omega.$

Fig.15 Common emitter input reflection coefficient (S_{11}); typical values.

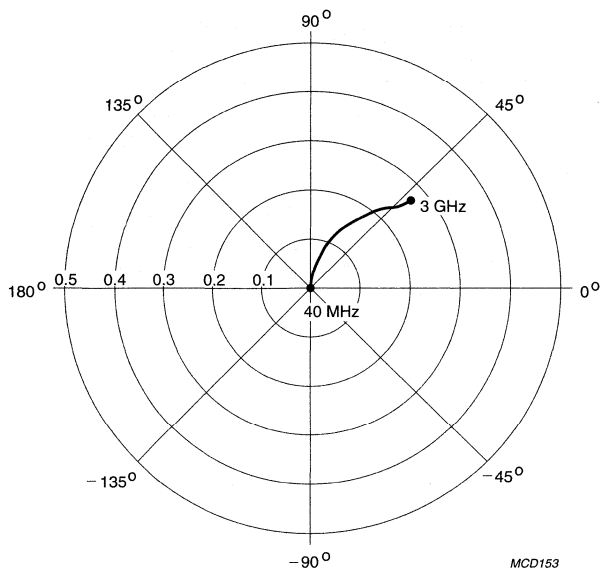


$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}.$

Fig.16 Common emitter forward transmission coefficient (S_{21}); typical values.

NPN 5 GHz wideband transistor

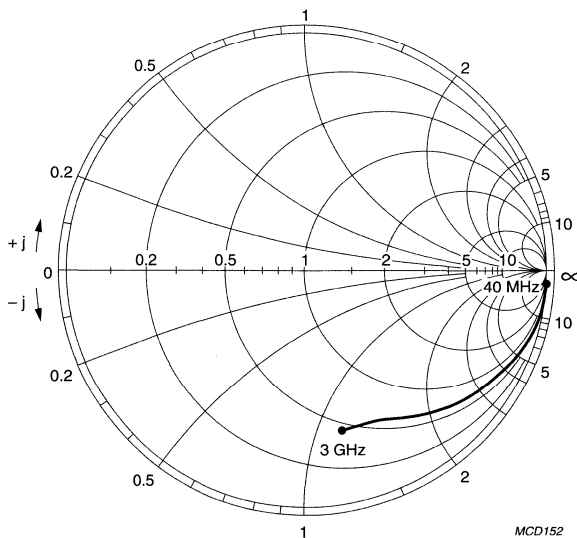
BFG25A/X



$I_C = 1\text{ mA}; V_{CE} = 1\text{ V}.$

MCD153

Fig.17 Common emitter reverse transmission coefficient (S_{12}); typical values.



$I_C = 1\text{ mA}; V_{CE} = 1\text{ V}; Z_0 = 50\ \Omega.$

MCD152

Fig.18 Common emitter output reflection coefficient (S_{22}); typical values.

NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR

FEATURES

- Low current consumption (100 μ A to 1 mA)
- Low noise figure
- Gold metallization ensures excellent reliability.

APPLICATIONS

They are intended for wideband applications in UHF low power amplifiers, such as pocket telephones, paging systems.

DESCRIPTION

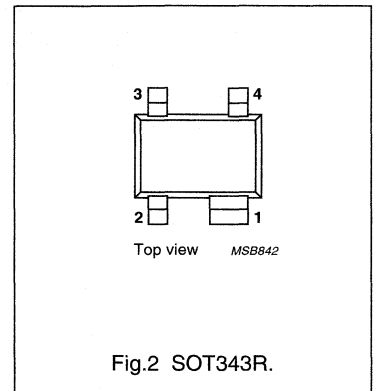
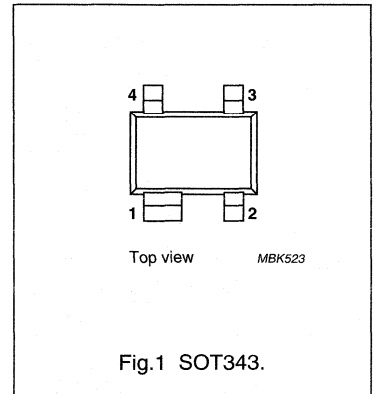
NPN silicon planar epitaxial transistors in plastic, 4-pin dual-emitter SOT343 and SOT343R packages.

MARKING

| TYPE NUMBER | CODE |
|-------------|------|
| BFG25AW | N6 |
| BFG25AW/X | V1 |
| BFG25AW/XR | V3 |

PINNING

| PIN | DESCRIPTION |
|-------------------------------|-------------|
| BFG25AW (see Fig.1) | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG25AW/X (see Fig.1) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG25AW/XR (see Fig.2) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 8 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 5 | V |
| I_C | collector current (DC) | | – | – | 6.5 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85^\circ\text{C}$ | – | – | 500 | mW |
| h_{FE} | DC current gain | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$ | 50 | 80 | 200 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 1\text{ V}$; $f = 1\text{ MHz}$ | – | 0.2 | 0.3 | pF |
| f_T | transition frequency | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25^\circ\text{C}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25^\circ\text{C}$ | – | 16 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$ | – | 2 | – | dB |

NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

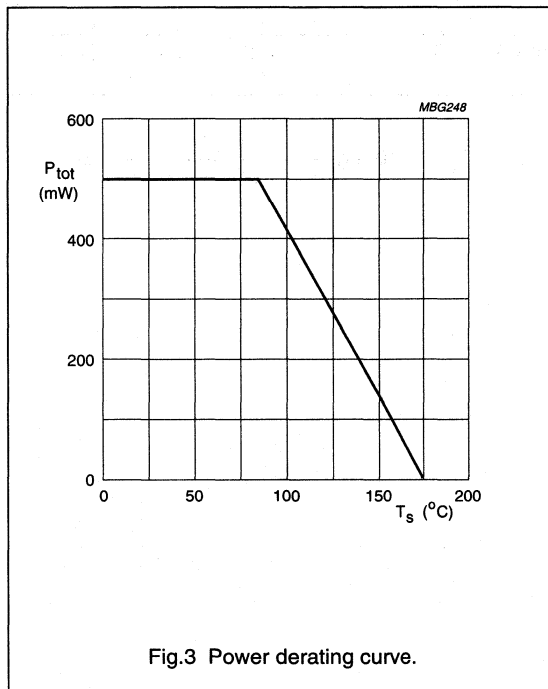
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 8 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 5 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | collector current (DC) | | – | 6.5 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ °C}$; see Fig.3; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|-------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 85\text{ °C}$; note 1 | 180 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.



NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR**CHARACTERISTICS** $T_j = 25\text{ °C}$ (unless otherwise specified).

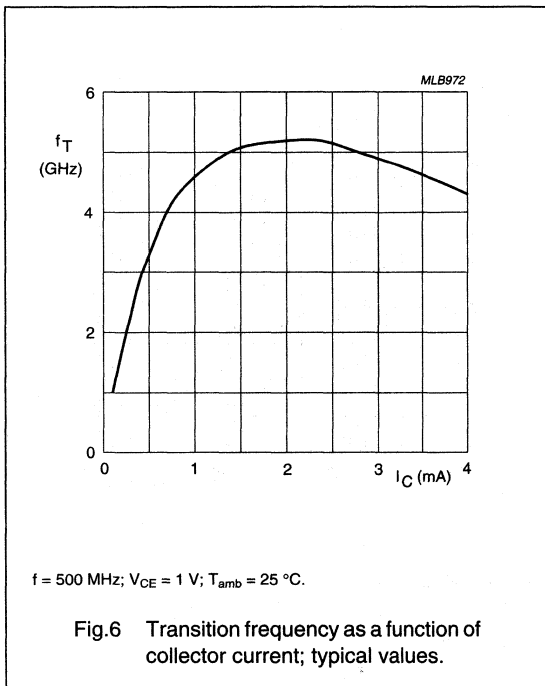
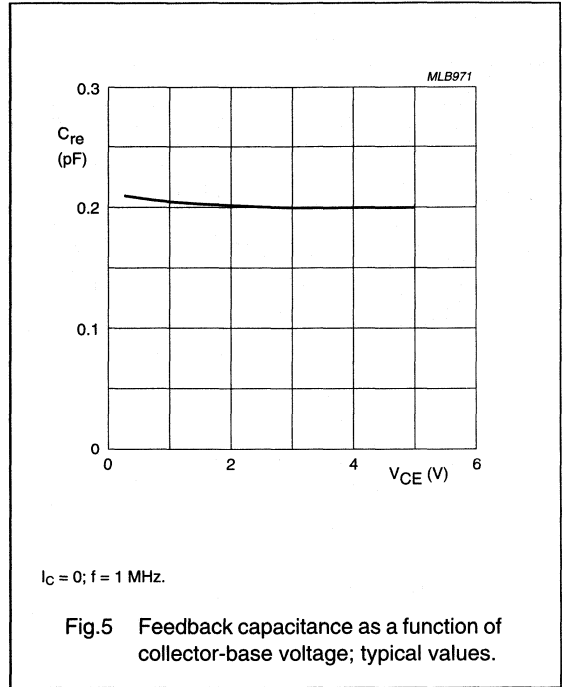
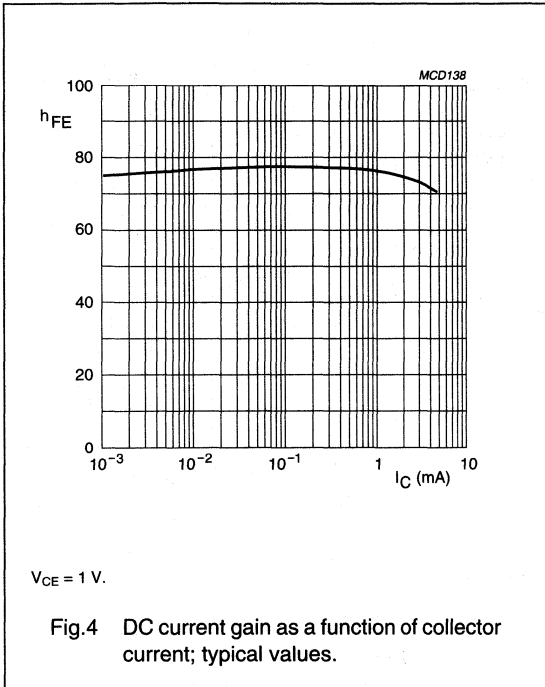
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---------------------------------------|--|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 100\ \mu\text{A}$; $I_E = 0$ | – | – | 8 | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 1\ \text{mA}$; $I_B = 0$ | – | – | 5 | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 100\ \mu\text{A}$; $I_C = 0$ | – | – | 2 | V |
| I_{CBO} | collector cut-off current | open emitter; $V_{CB} = 5\ \text{V}$; $I_E = 0$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 0.5\ \text{mA}$; $V_{CE} = 1\ \text{V}$ | 50 | 80 | 200 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 1\ \text{V}$; $f = 1\ \text{MHz}$ | – | 0.2 | 0.3 | pF |
| f_T | transition frequency | $I_C = 1\ \text{mA}$; $V_{CE} = 1\ \text{V}$; $f = 1\ \text{GHz}$; $T_{amb} = 25\text{ °C}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 0.5\ \text{mA}$; $V_{CE} = 1\ \text{V}$; $f = 1\ \text{GHz}$; $T_{amb} = 25\text{ °C}$ | – | 16 | – | dB |
| | | $I_C = 0.5\ \text{mA}$; $V_{CE} = 1\ \text{V}$; $f = 2\ \text{GHz}$; $T_{amb} = 25\text{ °C}$ | – | 8 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 0.5\ \text{mA}$; $V_{CE} = 1\ \text{V}$; $f = 1\ \text{GHz}$ | – | 1.9 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 1\ \text{mA}$; $V_{CE} = 1\ \text{V}$; $f = 1\ \text{GHz}$ | – | 2 | – | dB |

Note

1. G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

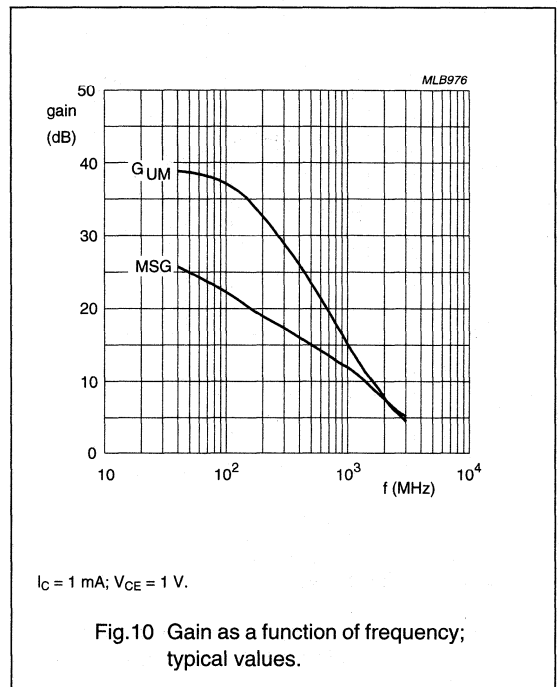
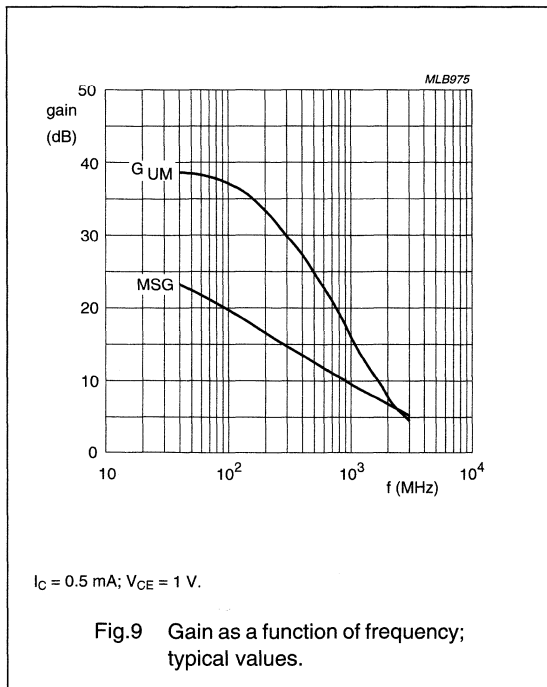
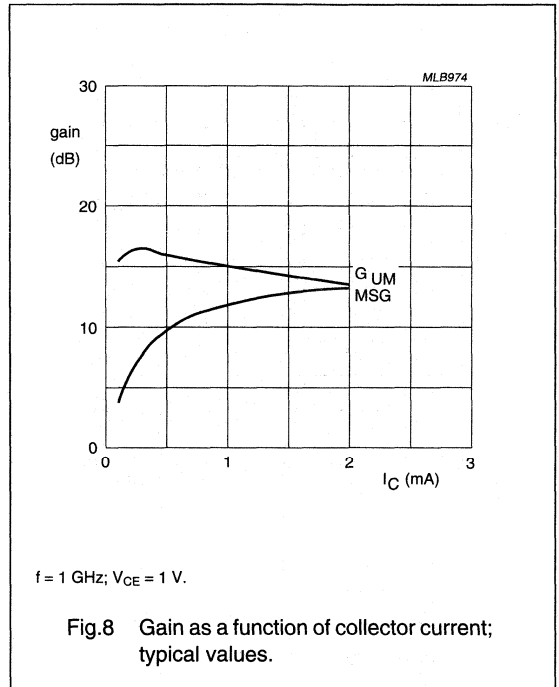
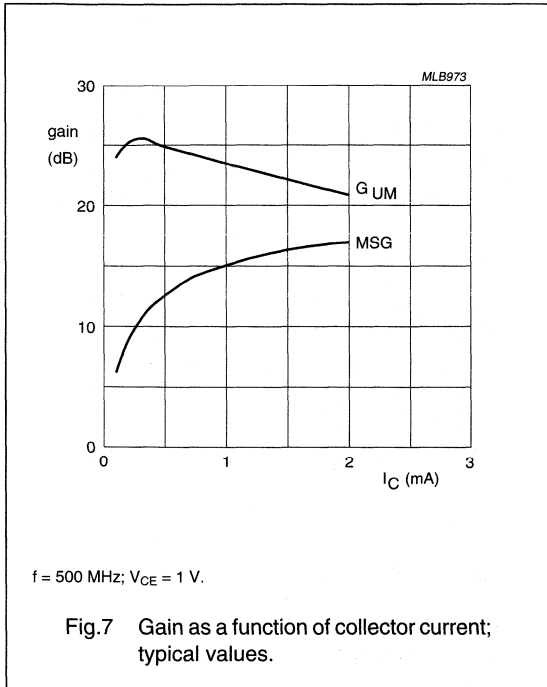
NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR



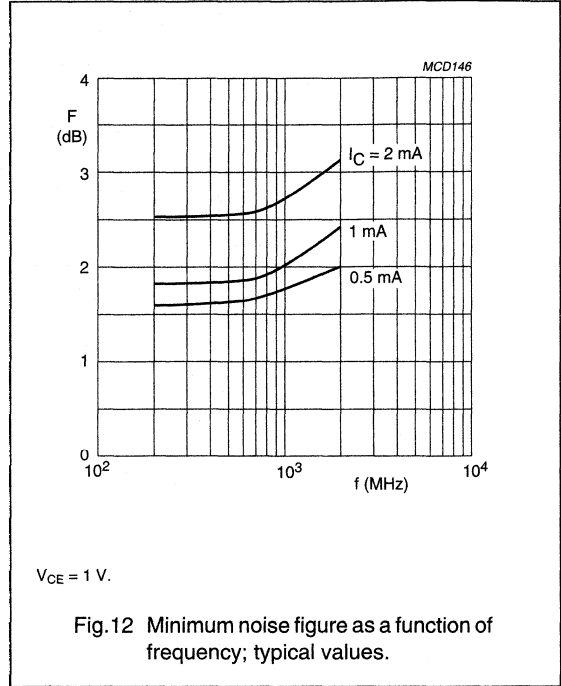
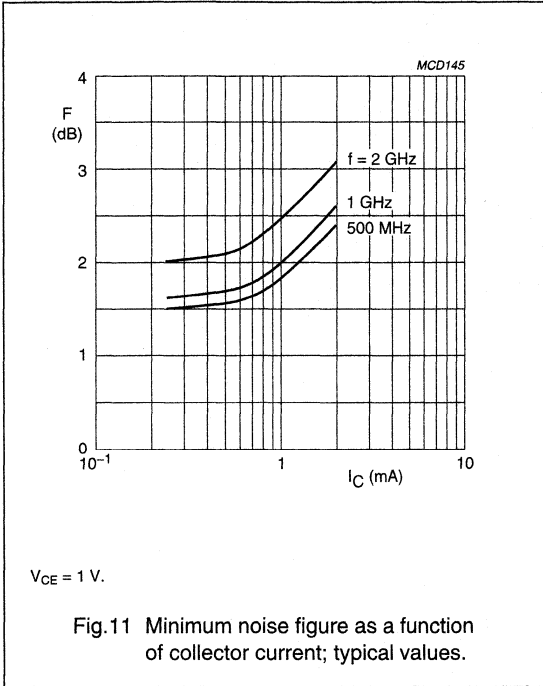
NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR



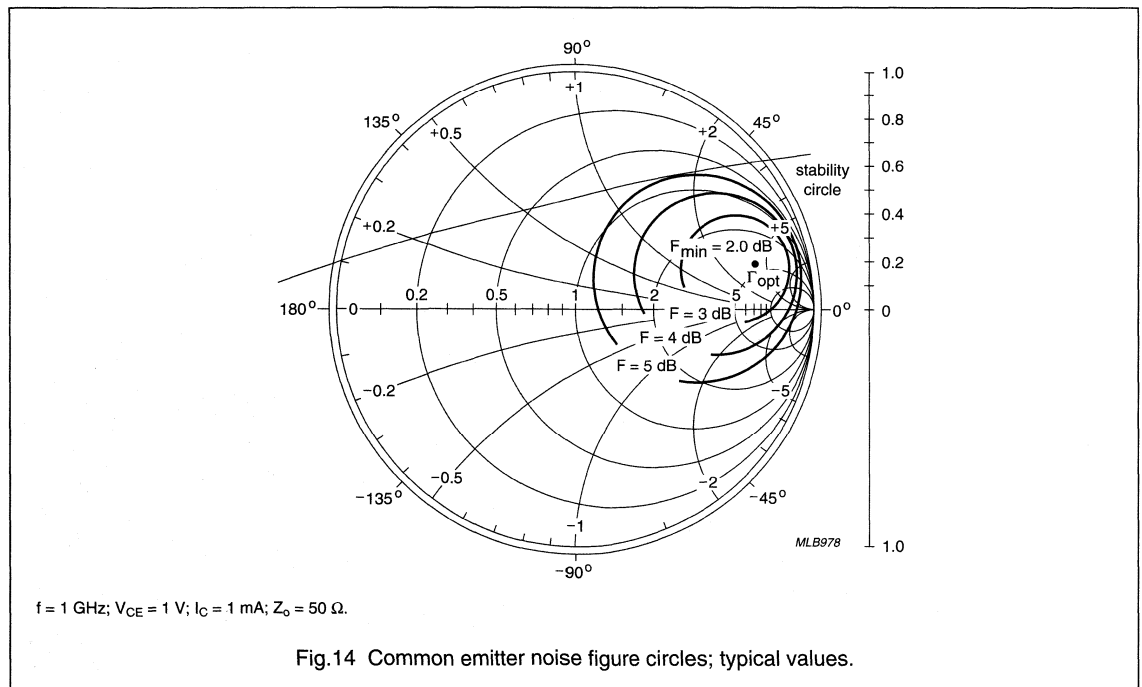
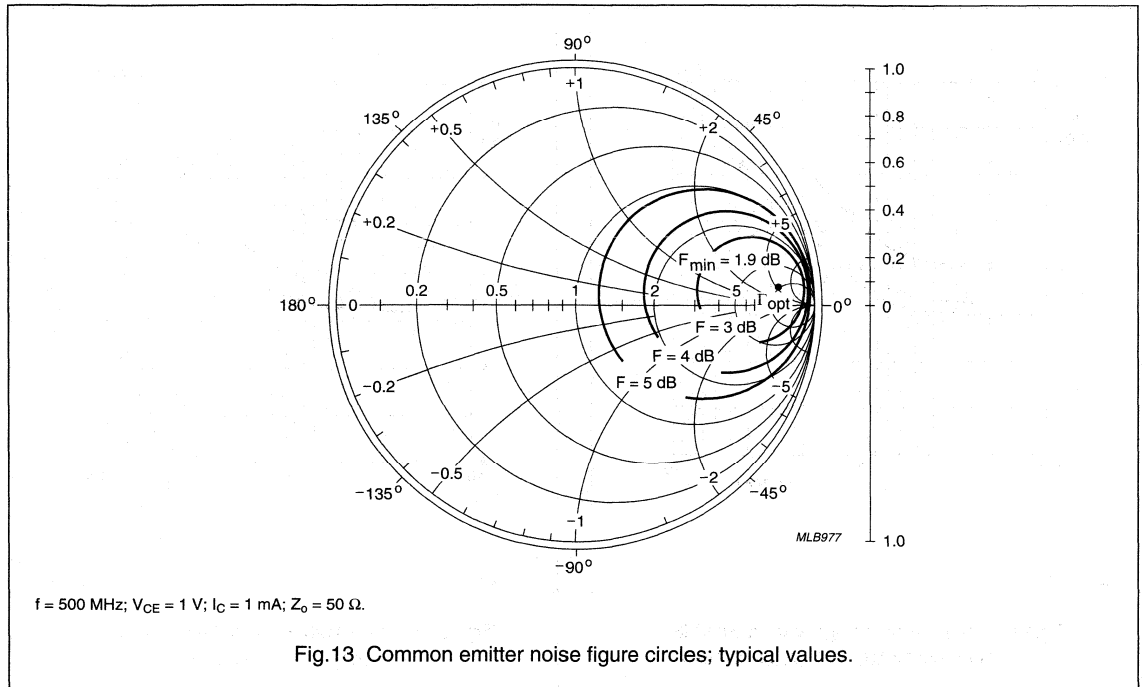
NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR



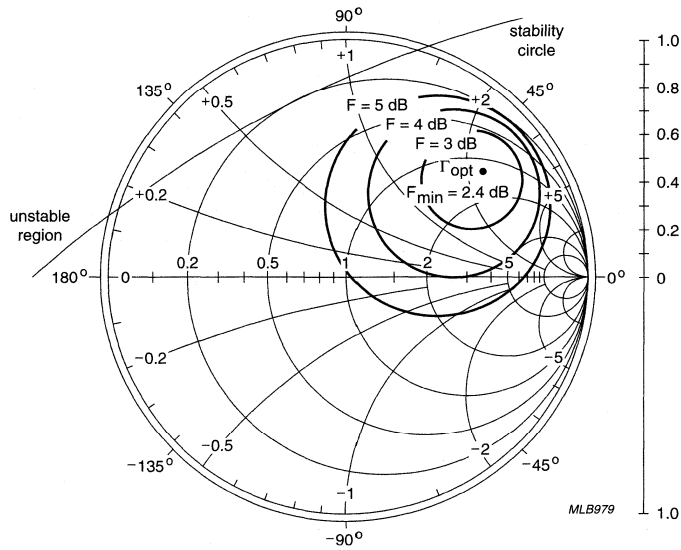
NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR



NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR



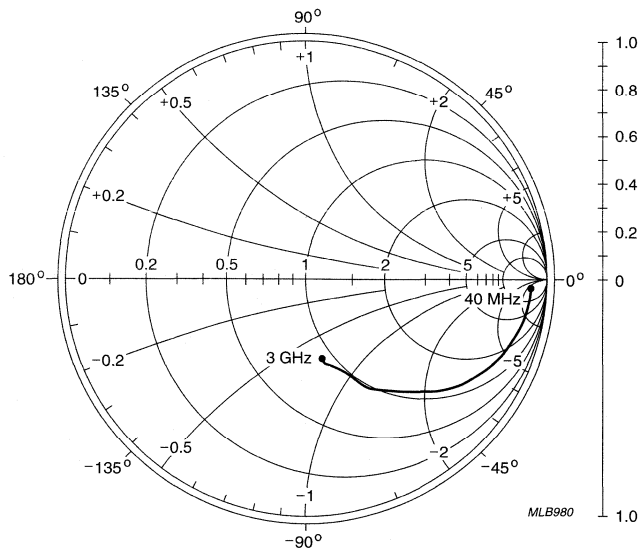
MLB979

$f = 2 \text{ GHz}; V_{CE} = 1 \text{ V}; I_C = 1 \text{ mA}; Z_0 = 50 \Omega.$

Fig.15 Common emitter noise figure circles; typical values.

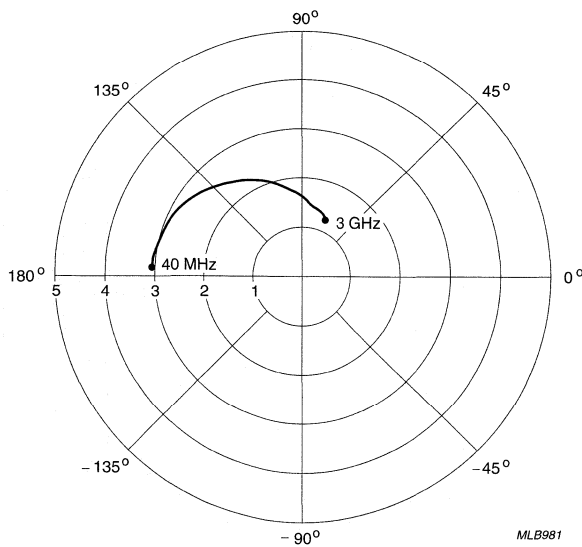
NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR



$V_{CE} = 1\text{ V}; I_C = 1\text{ mA}; Z_0 = 50\ \Omega$.

Fig.16 Common emitter input reflection coefficient (s_{11}); typical values.

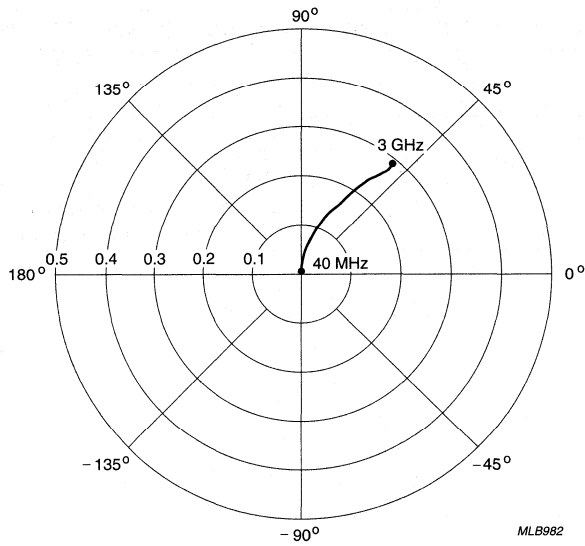


$V_{CE} = 1\text{ V}; I_C = 1\text{ mA}$.

Fig.17 Common emitter forward transmission coefficient (s_{21}); typical values.

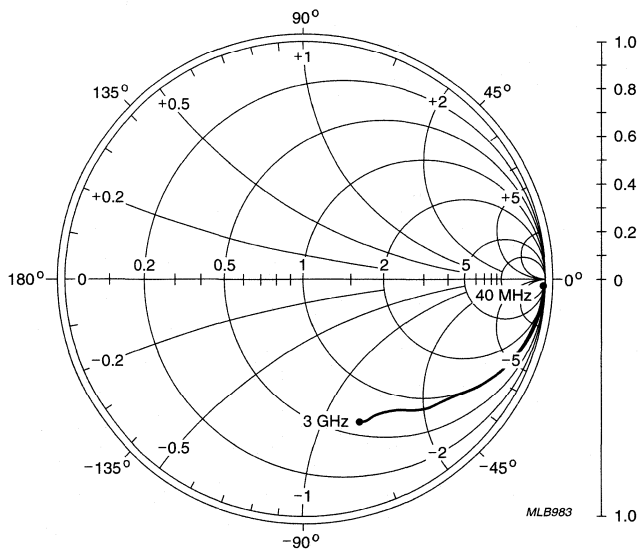
NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR



$V_{CE} = 1\text{ V}; I_C = 1\text{ mA}$.

Fig.18 Common emitter reverse transmission coefficient (s_{12}); typical values.



$V_{CE} = 1\text{ V}; I_C = 1\text{ mA}; Z_0 = 50\ \Omega$.

Fig.19 Common emitter output reflection coefficient (s_{22}); typical values.

NPN 5 GHz wideband transistor

BFG25AW
BFG25AW/X; BFG25AW/XR

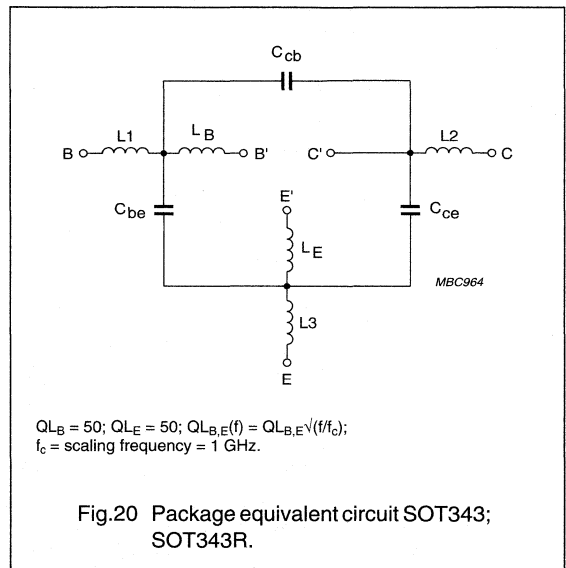
SPICE parameters for the BFG25W crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|----------|
| 1 | IS | 13.77 | aA |
| 2 | BF | 85.65 | – |
| 3 | NF | 0.980 | – |
| 4 | VAF | 50.80 | V |
| 5 | IKF | 10.00 | A |
| 6 | ISE | 2.199 | fA |
| 7 | NE | 1.857 | – |
| 8 | BR | 16.97 | – |
| 9 | NR | 0.986 | – |
| 10 | VAR | 2.491 | V |
| 11 | IKR | 188.0 | mA |
| 12 | ISC | 205.1 | aA |
| 13 | NC | 1.107 | – |
| 14 | RB | 80.00 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 80.00 | Ω |
| 17 | RE | 7.911 | Ω |
| 18 | RC | 5.300 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 223.0 | fF |
| 23 | VJE | 669.7 | mV |
| 24 | MJE | 0.060 | – |
| 25 | TF | 5.112 | ps |
| 26 | XTF | 7.909 | – |
| 27 | VTF | 1.338 | V |
| 28 | ITF | 5.662 | mA |
| 29 | PTF | 15.37 | deg |
| 30 | CJC | 229.0 | fF |
| 31 | VJC | 394.7 | mV |
| 32 | MJC | 0.043 | – |
| 33 | XCJC | 0.050 | – |
| 34 | TR | 13.26 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.988 | – |

Note

- These parameters have not been extracted, the default values are shown.

**List of components** (see Fig.20)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 70 | fF |
| C_{cb} | 50 | fF |
| C_{ce} | 115 | fF |
| L1 | 0.34 | nH |
| L2 | 0.10 | nH |
| L3 | 0.25 | nH |
| L_B | 0.40 | nH |
| L_E | 0.40 | nH |

PNP 5 GHz wideband transistor

BFG31

FEATURES

- High output voltage capability
- High gain bandwidth product
- Good thermal stability
- Gold metallization ensures excellent reliability.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |

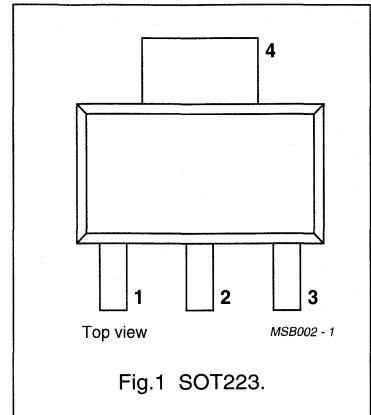


Fig.1 SOT223.

DESCRIPTION

PNP planar epitaxial transistor mounted in a plastic SOT223 envelope.

It is intended for wideband amplifier applications.

NPN complement is the BFG97.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | – | – | –15 | V |
| I_C | DC collector current | | – | – | –100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ °C}$; note 1 | – | – | 1 | W |
| h_{FE} | DC current gain | $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $T_{amb} = 25\text{ °C}$ | 25 | – | – | |
| f_T | transition frequency | $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 5.0 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 12 | – | dB |
| V_o | output voltage | $I_C = -100\text{ mA}$; $V_{CE} = -10\text{ V}$; $R_L = 75\text{ }\Omega$; $T_{amb} = 25\text{ °C}$ | – | 600 | – | mV |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CB0} | collector-base voltage | open emitter | – | –20 | V |
| V_{CE0} | collector-emitter voltage | open base | – | –15 | V |
| V_{EB0} | emitter-base voltage | open collector | – | –3 | V |
| I_C | DC collector current | | – | –100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ °C}$; note 1 | – | 1 | W |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

1. T_s is the temperature at the soldering point of the collector tab.

PNP 5 GHz wideband transistor

BFG31

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 135\text{ °C}$; note 1 | 40 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

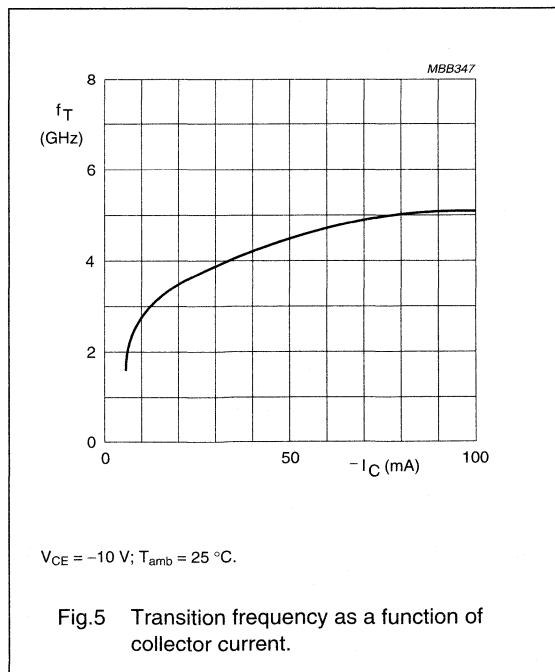
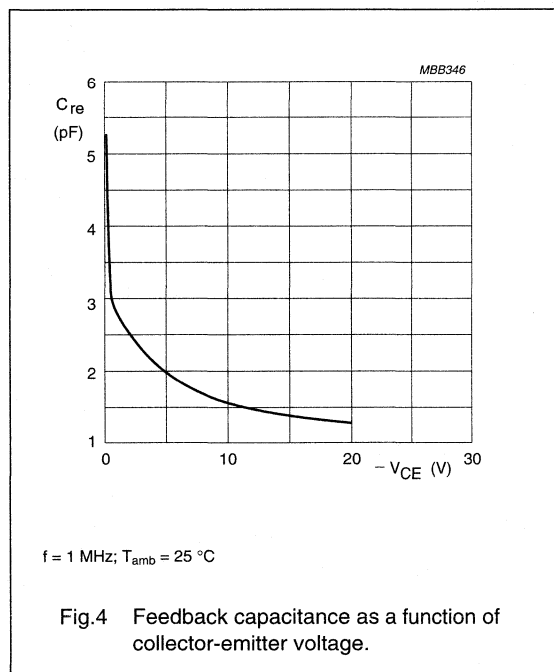
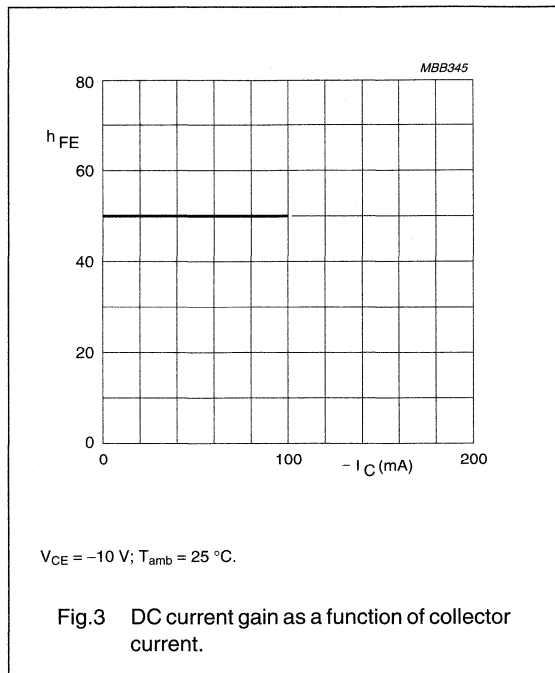
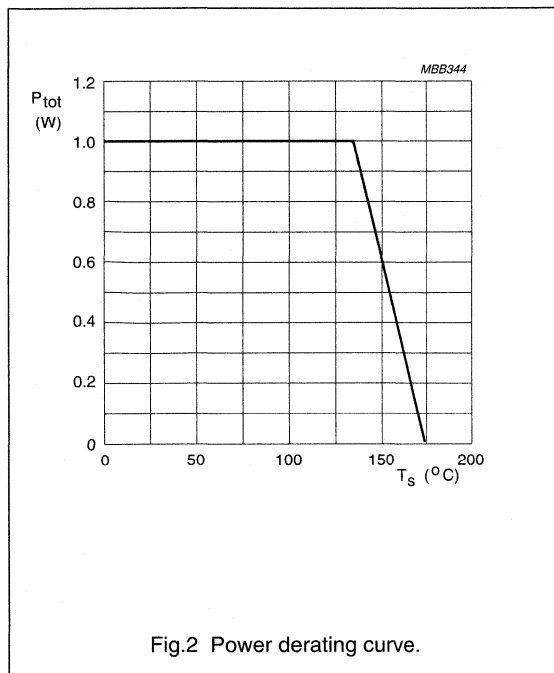
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---------------------------------------|--|------|------|------|---------------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = -10\text{ mA}$ | -20 | - | - | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = -10\text{ mA}$ | -18 | - | - | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = -0.1\text{ mA}$ | -3 | - | - | V |
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = -10\text{ V}$ | - | - | -1 | μA |
| h_{FE} | DC current gain | $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $T_{amb} = 25\text{ °C}$ | 25 | - | - | |
| C_{cb} | collector-base capacitance | $I_C = 0$; $V_{CB} = -10\text{ V}$; $f = 1\text{ MHz}$; | - | 1.8 | - | pF |
| C_{eb} | emitter-base capacitance | $I_C = 0$; $V_{EB} = -10\text{ V}$; $f = 1\text{ MHz}$; | - | 5 | - | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = -10\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | - | 1.6 | - | pF |
| f_T | transition frequency | $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | - | 5 | - | GHz |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | - | 16 | - | dB |
| | | $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | - | 12 | - | dB |
| V_o | output voltage | note 2 | - | 600 | - | mV |
| V_o | output voltage | note 3 | - | 550 | - | mV |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.
- $d_{im} = -60\text{ dB}$; $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$;
 $V_p = V_o$ at $d_{im} = -60\text{ dB}$; $f_p = 850.25\text{ MHz}$;
 $V_q = V_o - 6\text{ dB}$; $f_q = 858.25\text{ MHz}$;
 $V_r = V_o - 6\text{ dB}$; $f_r = 860.25\text{ MHz}$;
 measured at $f_{(p+q-r)} = 848.25\text{ MHz}$.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$;
 $V_p = V_o$ at $d_{im} = -60\text{ dB}$; $f_p = 445.25\text{ MHz}$;
 $V_q = V_o - 6\text{ dB}$; $f_q = 453.25\text{ MHz}$;
 $V_r = V_o - 6\text{ dB}$; $f_r = 455.25\text{ MHz}$;
 measured at $f_{(p+q-r)} = 443.25\text{ MHz}$.

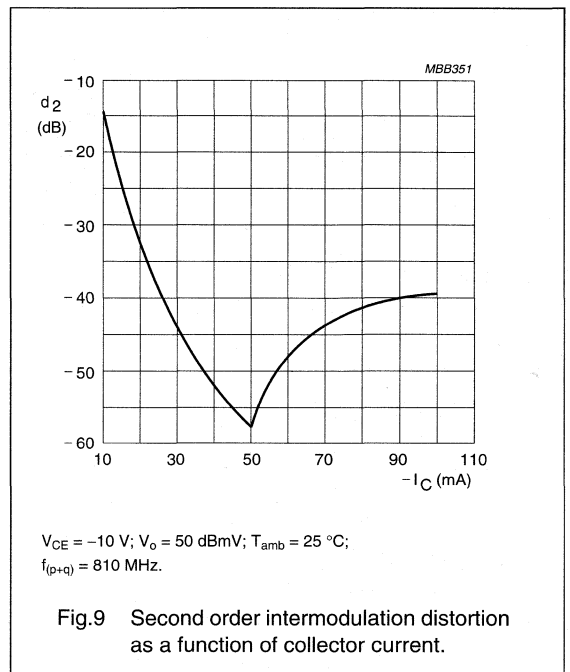
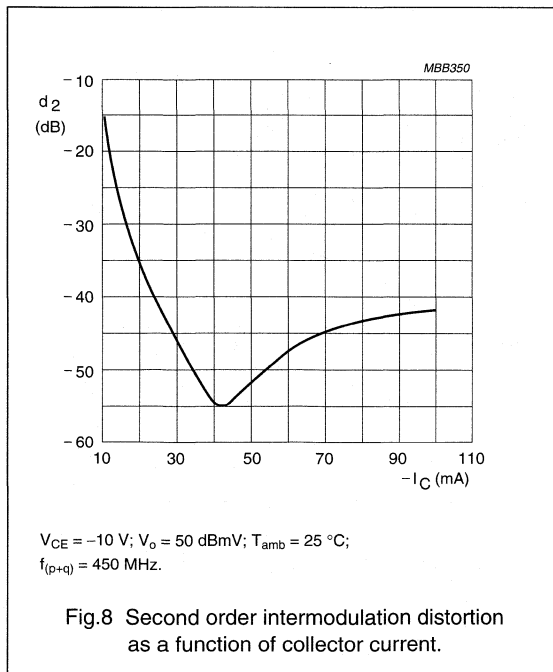
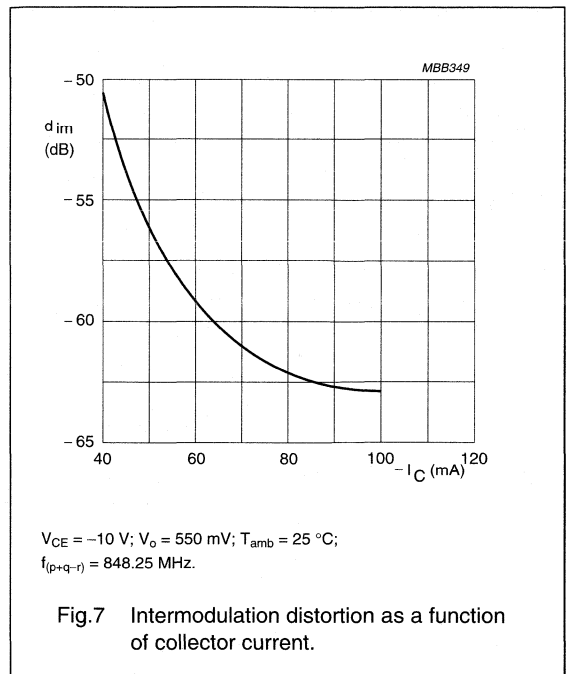
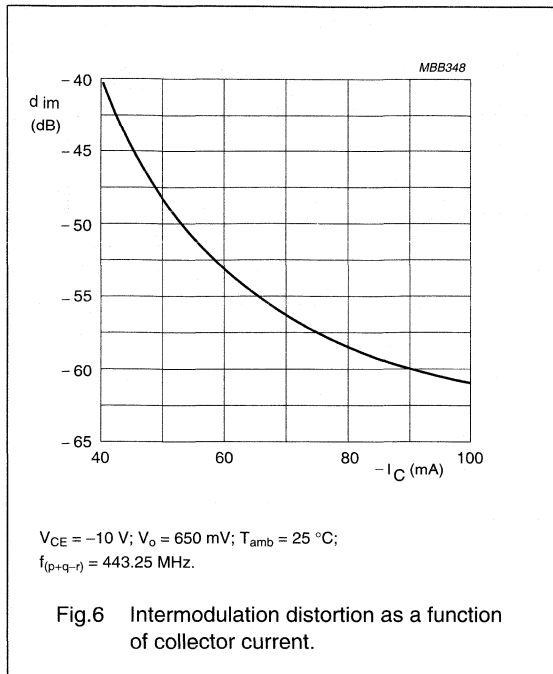
PNP 5 GHz wideband transistor

BFG31



PNP 5 GHz wideband transistor

BFG31



NPN 4 GHz wideband transistor

BFG35

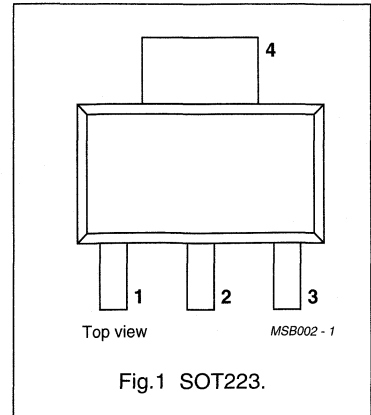
DESCRIPTION

NPN planar epitaxial transistor mounted in a plastic SOT223 envelope, intended for wideband amplifier applications. It features high output voltage capabilities.

PNP complement is the BFG55.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CEO} | collector-emitter voltage | open base | – | – | 18 | V |
| I_C | DC collector current | | – | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ °C}$ (note 1) | – | – | 1 | W |
| h_{FE} | DC current gain | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_j = 25\text{ °C}$ | 25 | 70 | – | |
| f_T | transition frequency | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 4 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| | | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 11 | – | dB |
| V_o | output voltage | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $d_{im} = -60\text{ dB}$; $R_L = 75\text{ }\Omega$; $f_{(p+q-r)} = 793.25\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 750 | – | mV |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 18 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ °C}$ (note 1) | – | 1 | W |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 4 GHz wideband transistor

BFG35

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|--------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 135\text{ °C}$ (note 1) | 40 | K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--|------|------|------|---------------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 10\text{ V}$ | – | – | 1 | μA |
| h_{FE} | DC current gain | $I_C = 100\text{ mA}; V_{CE} = 10\text{ V}$ | 25 | 70 | – | |
| C_C | collector capacitance | $I_E = I_E = 0; V_{CB} = 10\text{ V}; f = 1\text{ MHz}$ | – | 2 | – | pF |
| C_e | emitter capacitance | $I_C = I_C = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 10 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = 10\text{ V}; f = 1\text{ MHz}$ | – | 1.2 | – | pF |
| f_T | transition frequency | $I_C = 100\text{ mA}; V_{CE} = 10\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 4 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 100\text{ mA}; V_{CE} = 10\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| | | $I_C = 100\text{ mA}; V_{CE} = 10\text{ V};$ $f = 800\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 11 | – | dB |
| V_o | output voltage | note 2 | – | 750 | – | mV |
| | | note 3 | – | 800 | – | mV |
| d_2 | second order intermodulation distortion | note 4 | – | –55 | – | dB |
| | | note 5 | – | –57 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 100\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\ \Omega; T_{amb} = 25\text{ °C}$
 $V_p = V_o$ at $d_{im} = -60\text{ dB}; f_p = 795.25\text{ MHz};$
 $V_q = V_o - 6\text{ dB}; f_q = 803.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_r = 805.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 793.25\text{ MHz}.$
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 100\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\ \Omega; T_{amb} = 25\text{ °C}$
 $V_p = V_o$ at $d_{im} = -60\text{ dB}; f_p = 445.25\text{ MHz};$
 $V_q = V_o - 6\text{ dB}; f_q = 453.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_r = 455.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 443.25\text{ MHz}.$
- $I_C = 60\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\ \Omega;$
 $V_p = V_q = V_o = 50\text{ dBmV};$
 $f_{(p+q)} = 450\text{ MHz}; f_p = 50\text{ MHz}; f_q = 400\text{ MHz}.$
- $I_C = 60\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\ \Omega;$
 $V_p = V_q = V_o = 50\text{ dBmV};$
 $f_{(p+q)} = 810\text{ MHz}; f_p = 250\text{ MHz}; f_q = 560\text{ MHz}.$

NPN 4 GHz wideband transistor

BFG35

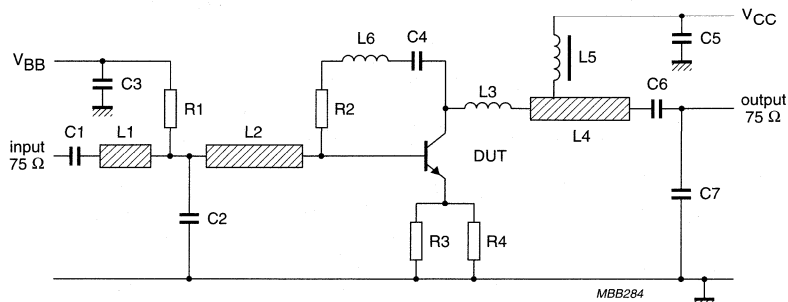


Fig.2 Intermodulation and second harmonic test circuit.

List of components (see test circuit)

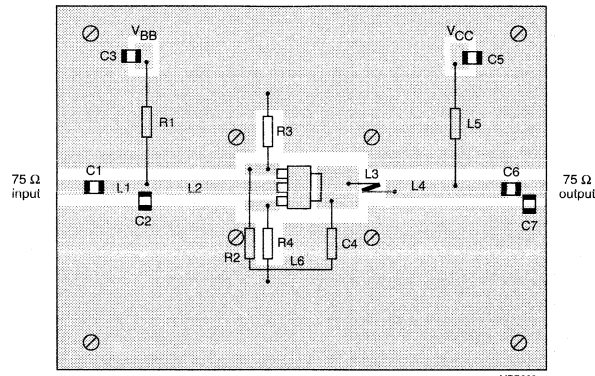
| DESIGNATION | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE NO. |
|----------------|-----------------------------------|--------|---------------------------------------|----------------|
| C1, C3, C5, C6 | multilayer ceramic capacitor | 10 nF | | 2222 590 08627 |
| C2, C7 | multilayer ceramic capacitor | 1 pF | | 2222 851 12108 |
| C4 (note 1) | miniature ceramic plate capacitor | 10 nF | | 2222 629 08103 |
| L1 | microstripline | 75 Ω | length 7mm; width 2.5 mm | |
| L2 | microstripline | 75 Ω | length 22mm; width 2.5 mm | |
| L3 (note 1) | 1.5 turns 0.4 mm copper wire | | int. dia. 3 mm; winding pitch 1 mm | |
| L4 | microstripline | 75 Ω | length 19 mm; width 2.5 mm | |
| L5 | Ferroxcube choke | 5 μH | | 3122 108 20153 |
| L6 (note 1) | 0.4 mm copper wire | ≈25 nH | length 30 mm | |
| R1 | metal film resistor | 10 kΩ | | 2322 180 73103 |
| R2 (note 1) | metal film resistor | 200 Ω | | 2322 180 73201 |
| R3, R4 | metal film resistor | 27 Ω | | 2322 180 73279 |

Notes

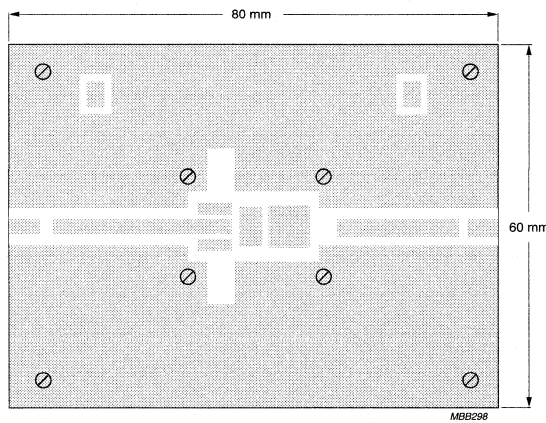
- Components C4, L3, L6 and R2 are mounted on the underside of the PCB.
The circuit is constructed on a double copper-clad printed circuit board with PTFE dielectric ($\epsilon_r = 2.2$); thickness $\frac{1}{16}$ inch; thickness of copper sheet $\frac{1}{32}$ inch.

NPN 4 GHz wideband transistor

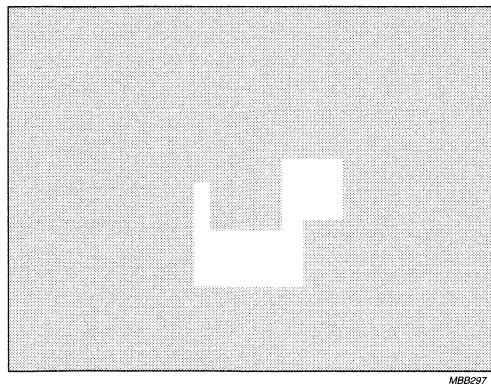
BFG35



MBB299



MBB298

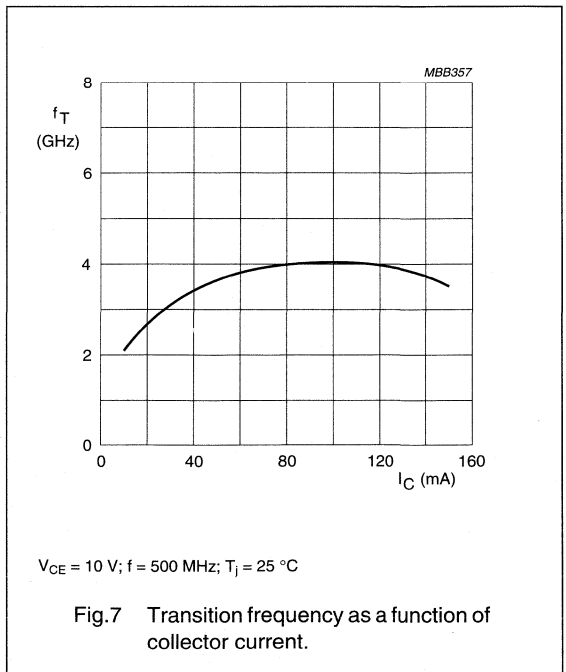
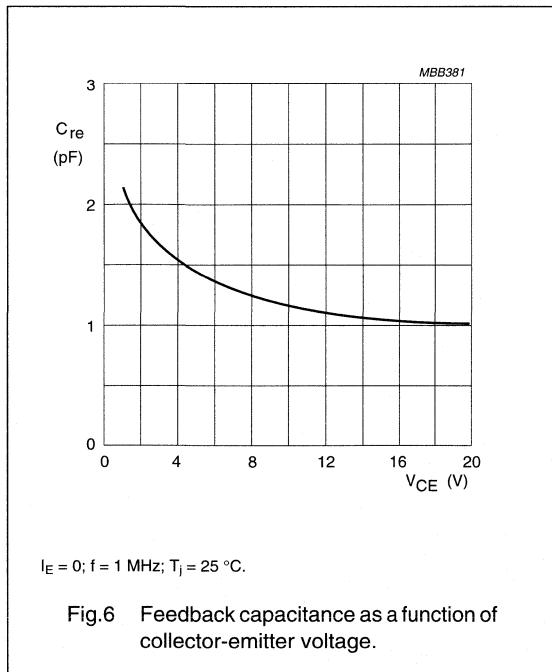
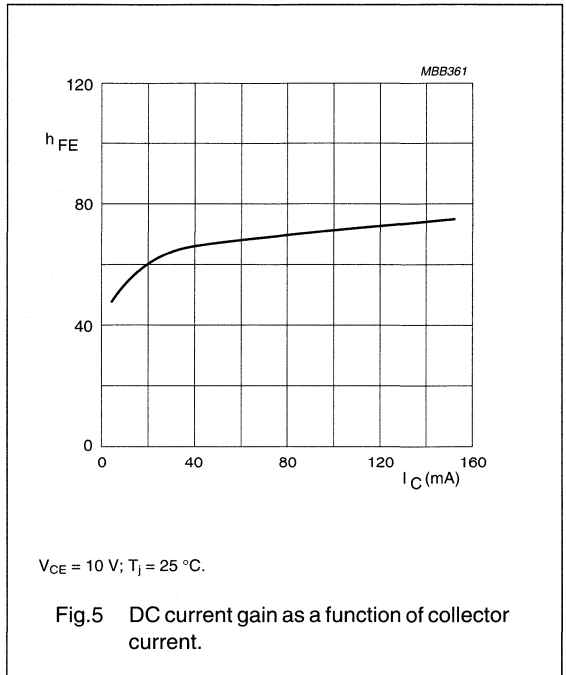
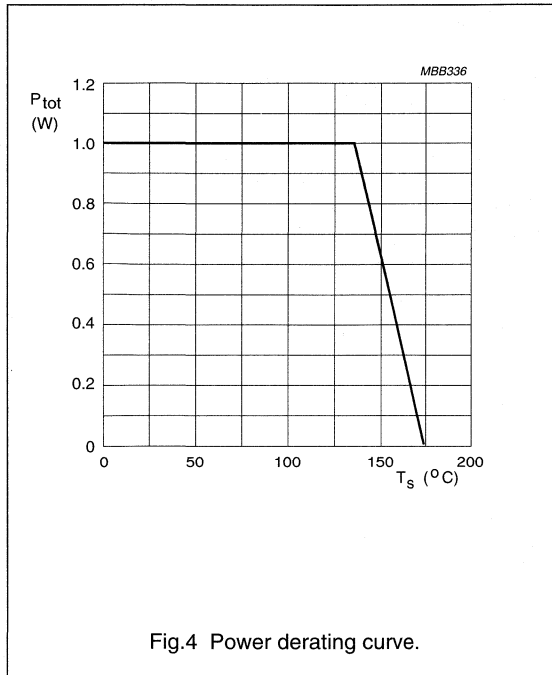


MBB297

Fig.3 Intermodulation test circuit printed circuit board.

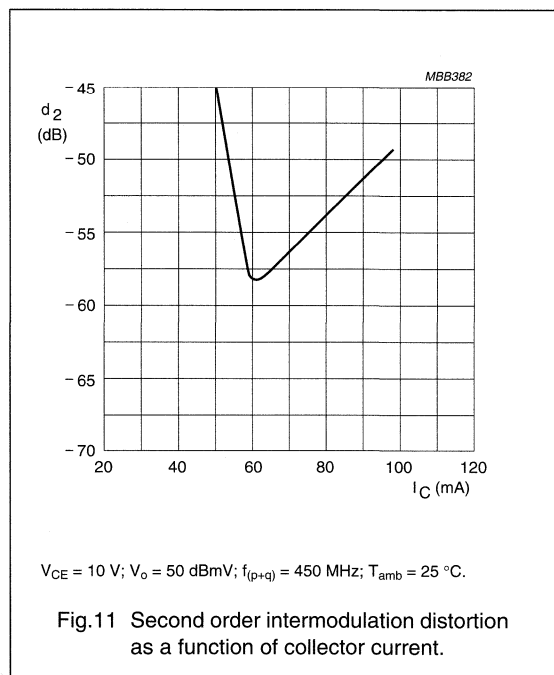
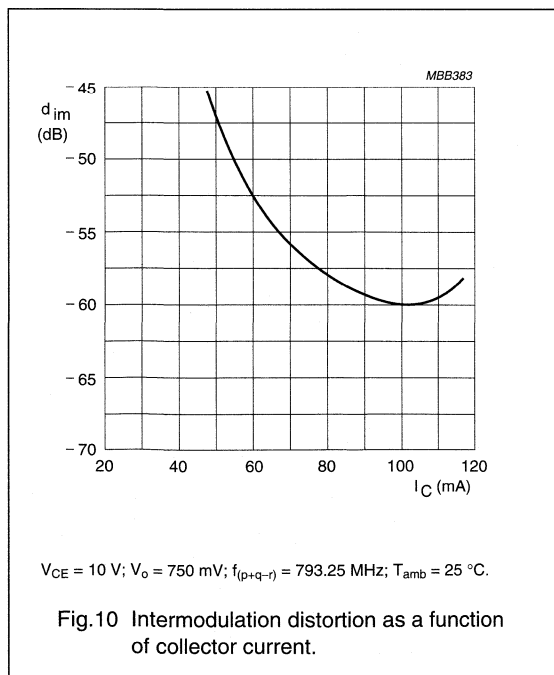
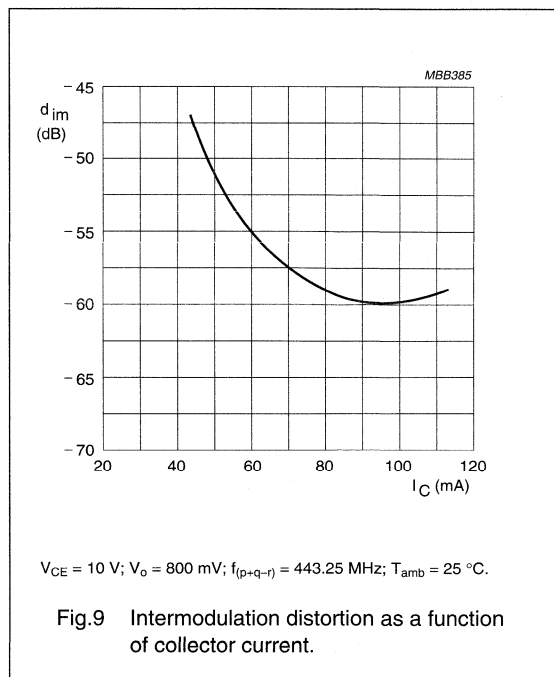
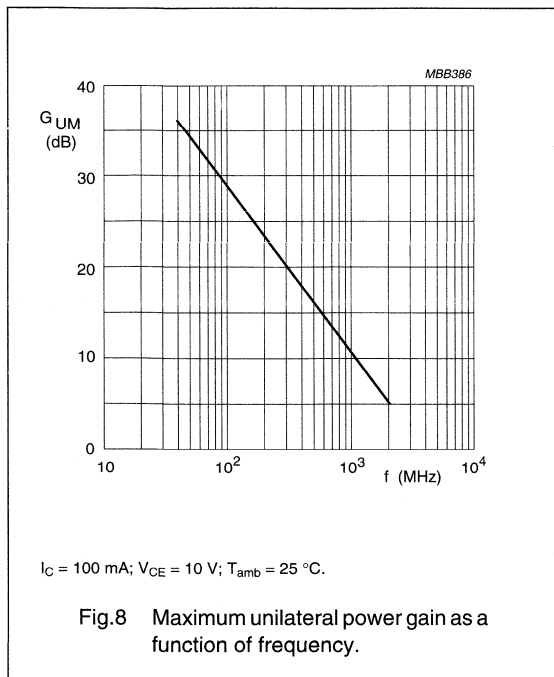
NPN 4 GHz wideband transistor

BFG35



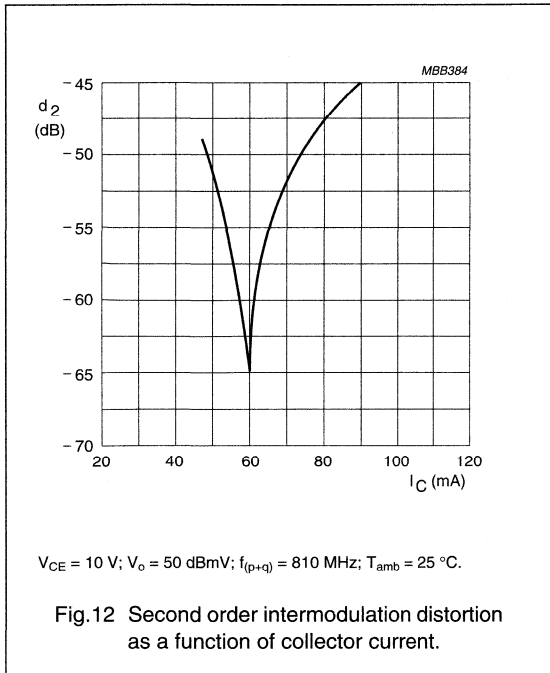
NPN 4 GHz wideband transistor

BFG35



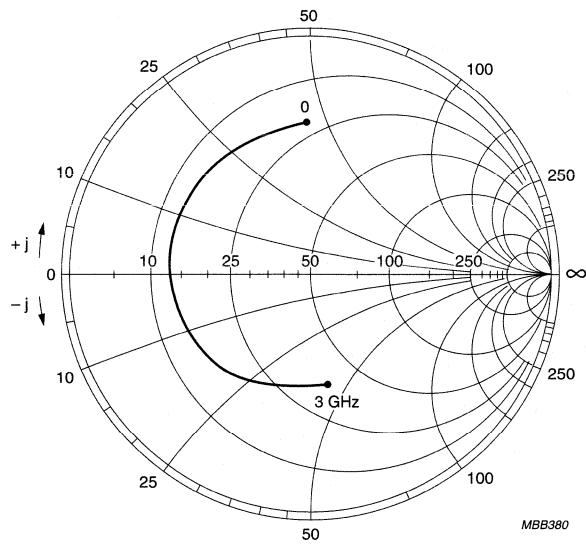
NPN 4 GHz wideband transistor

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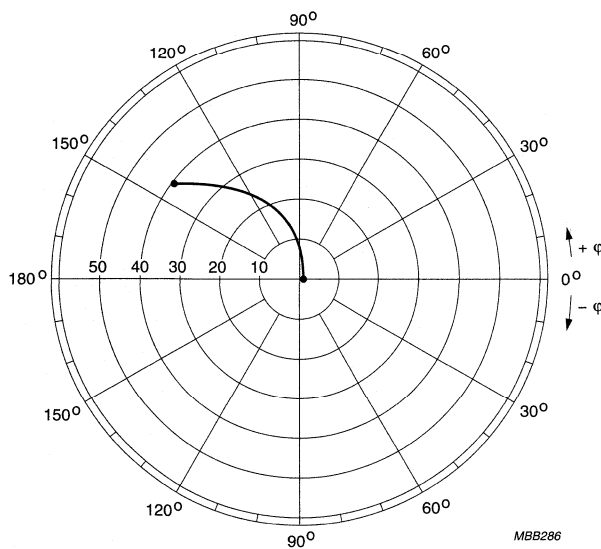
NPN 4 GHz wideband transistor

BFG35



$I_C = 100 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$; $Z_0 = 50 \text{ } \Omega$.

Fig.13 Common emitter input reflection coefficient (S_{11}).

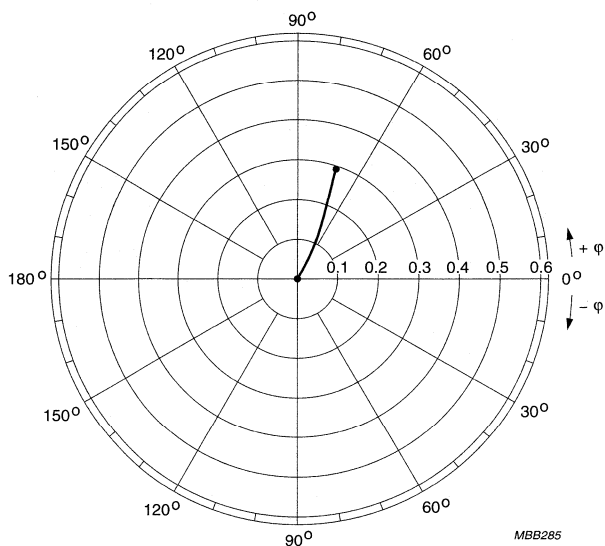


$I_C = 100 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.14 Common emitter forward transmission coefficient (S_{21}).

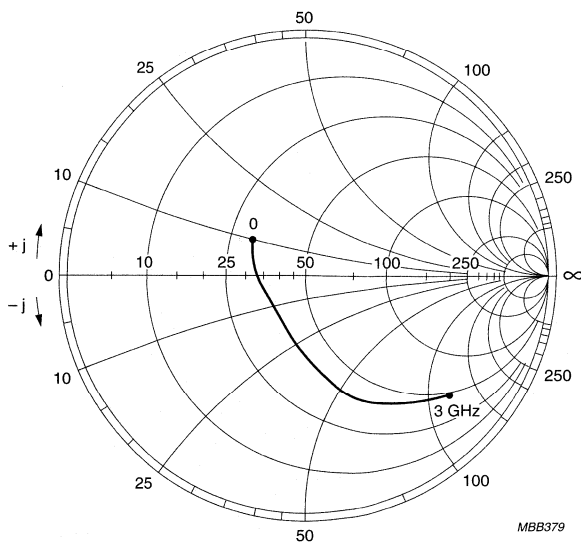
NPN 4 GHz wideband transistor

BFG35



$I_C = 100 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.15 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 100 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$; $Z_o = 50 \text{ } \Omega$.

Fig.16 Common emitter output reflection coefficient (S_{22}).

NPN 8 GHz wideband transistor

BFG67; BFG67/X; BFG67R; BFG67/XR

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

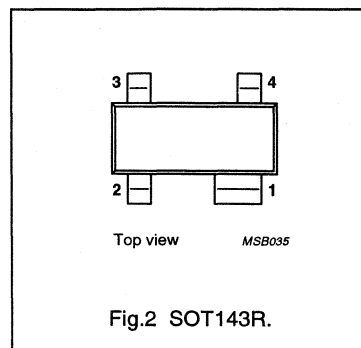
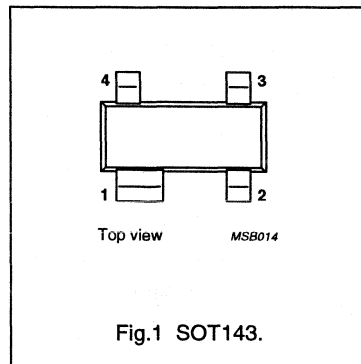
DESCRIPTION

The BFG67 is a silicon npn transistor in a 4-pin, dual-emitter plastic SOT143 envelope. It is available as in-line emitter pinning (BFG67) and cross emitter pinning (BFG67/X). Versions with reverse pinning (BFG67R and BFG67/XR) are available upon request.

This transistor is designed for wideband applications in the GHz range, such as satellite TV tuners and portable RF communications equipment.

PINNING

| PIN | DESCRIPTION |
|----------------------------|-------------|
| BFG67 (Fig.1) Code: V3. | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG67/X (Fig.1) Code: V12 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG67R (Fig.2) Code: V27 | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG67/XR (Fig.2) Code: V26 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | - | - | 10 | V |
| I_C | DC collector current | | - | - | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 65^\circ\text{C}$ (note 1) | - | - | 300 | mW |
| C_{re} | feedback capacitance | $I_C = I_c = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | - | 0.5 | - | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 500\text{ MHz}$ | - | 8 | - | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25^\circ\text{C}$; $f = 1\text{ GHz}$ | - | 17 | - | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25^\circ\text{C}$; $f = 1\text{ GHz}$ | - | 1.3 | - | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25^\circ\text{C}$; $f = 2\text{ GHz}$ | - | 2.2 | - | dB |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 8 GHz wideband transistor

BFG67; BFG67/X;
BFG67R; BFG67XR**LIMITING VALUES**

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 65\text{ °C}$ (note 1) | – | 380 | mW |
| T_{stg} | storage temperature range | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 290 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 8 GHz wideband transistor

BFG67; BFG67/X;
BFG67R; BFG67/XR

CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

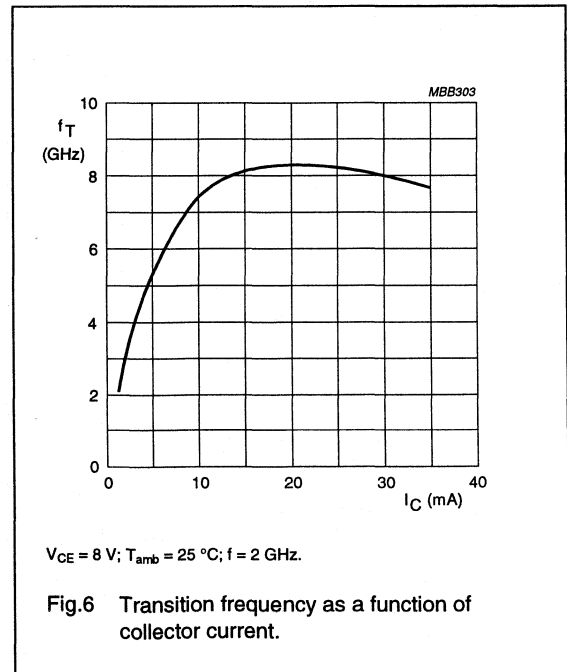
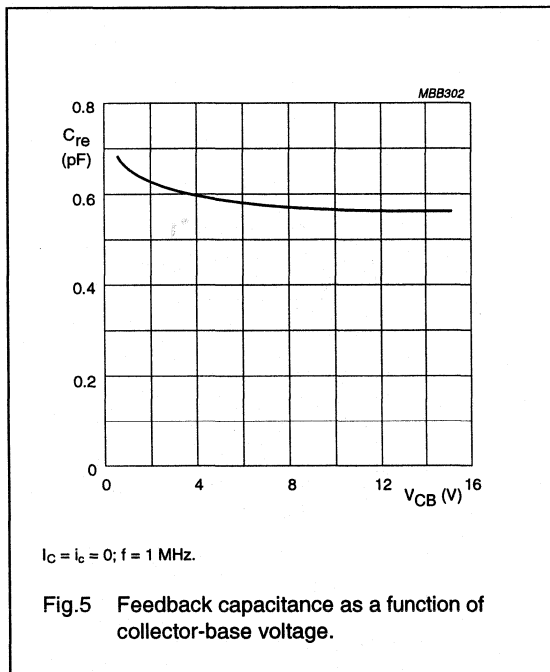
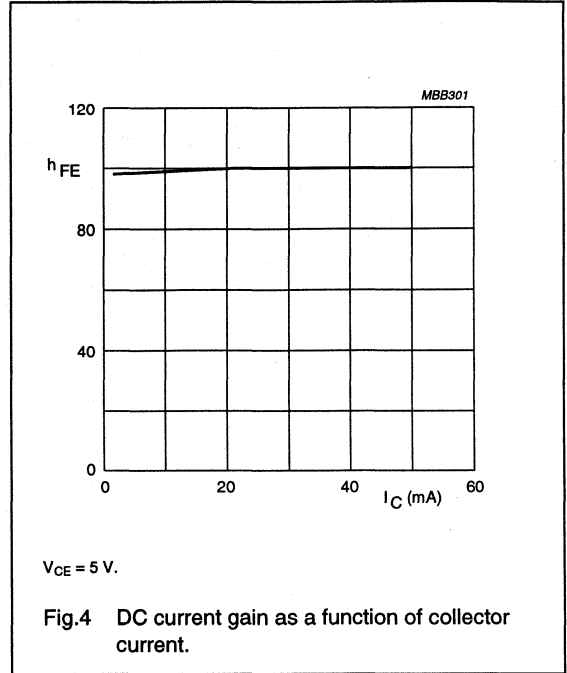
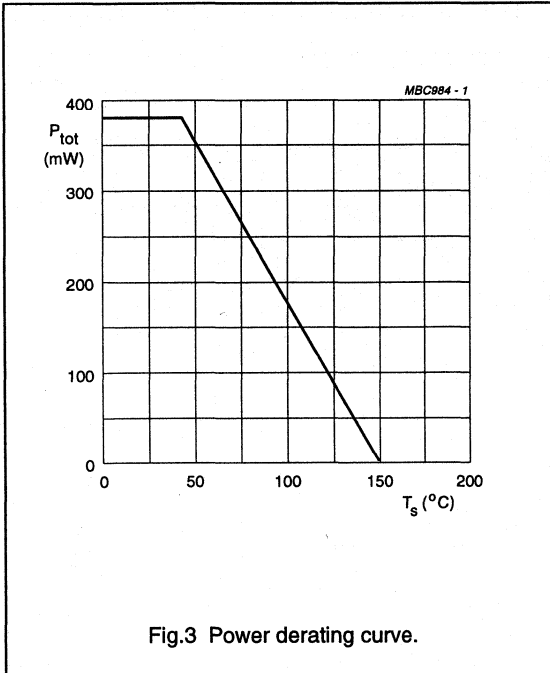
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | open emitter; $I_E = 0$; $V_{CB} = 5\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 15\text{ mA}$; $V_{CE} = 5\text{ V}$ | 60 | 100 | – | |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 500\text{ MHz}$ | – | 8 | – | GHz |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.3 | – | pF |
| C_{re} | feedback capacitance | $I_C = i_c = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 17 | – | dB |
| | | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 10 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 1.3 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 1.7 | – | dB |
| | | $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$; $Z_S = 60\ \Omega$ | – | 2.5 | – | dB |
| | | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$; $Z_S = 60\ \Omega$ | – | 3 | – | dB |

Note

1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

NPN 8 GHz wideband transistor

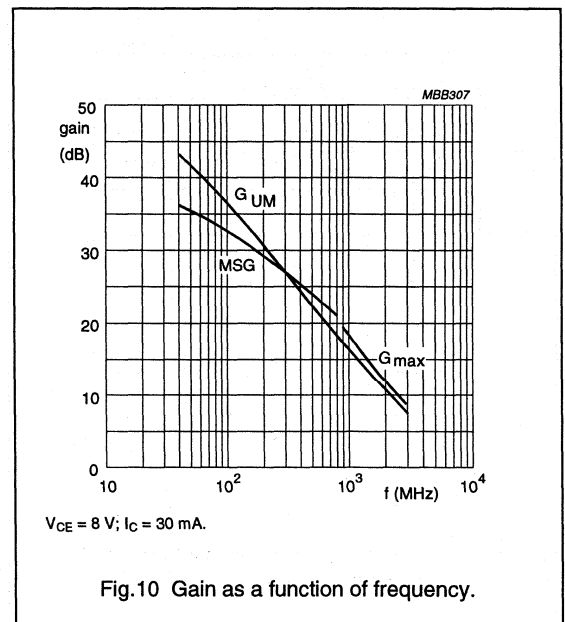
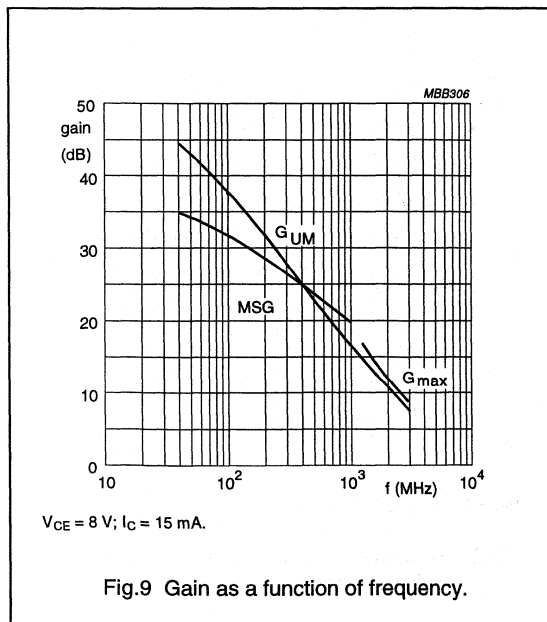
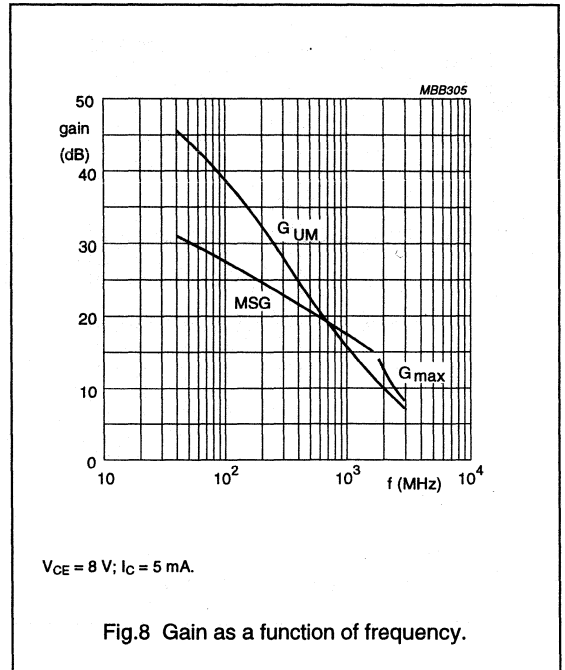
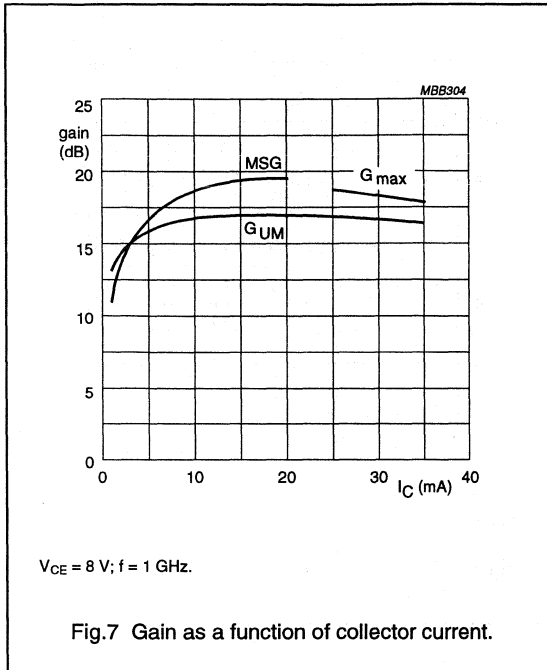
BFG67; BFG67/X;
BFG67R; BFG67/XR



NPN 8 GHz wideband transistor

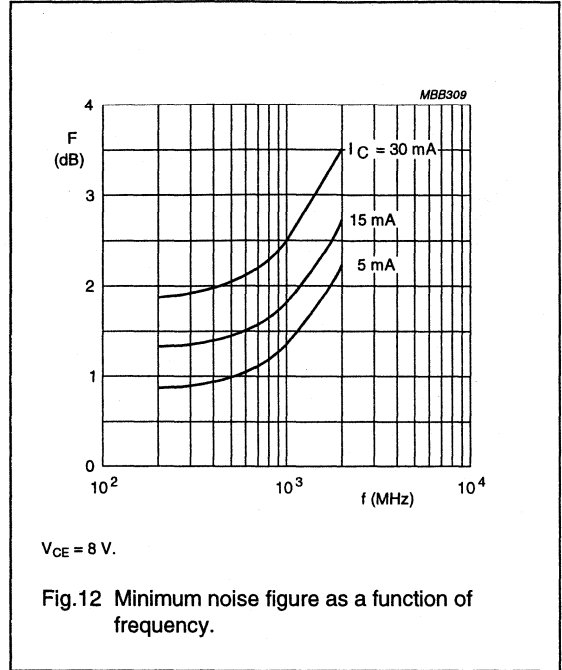
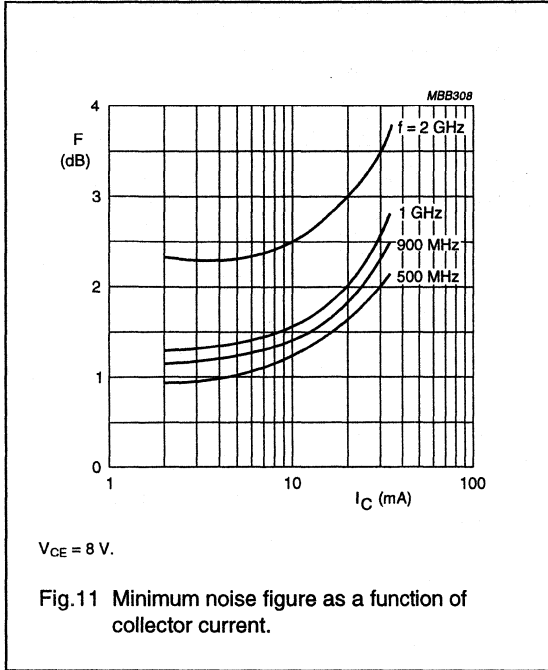
BFG67; BFG67/X;
BFG67R; BFG67/XR

In Figs 7 to 10, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



NPN 8 GHz wideband transistor

BFG67; BFG67/X;
BFG67R; BFG67/XR

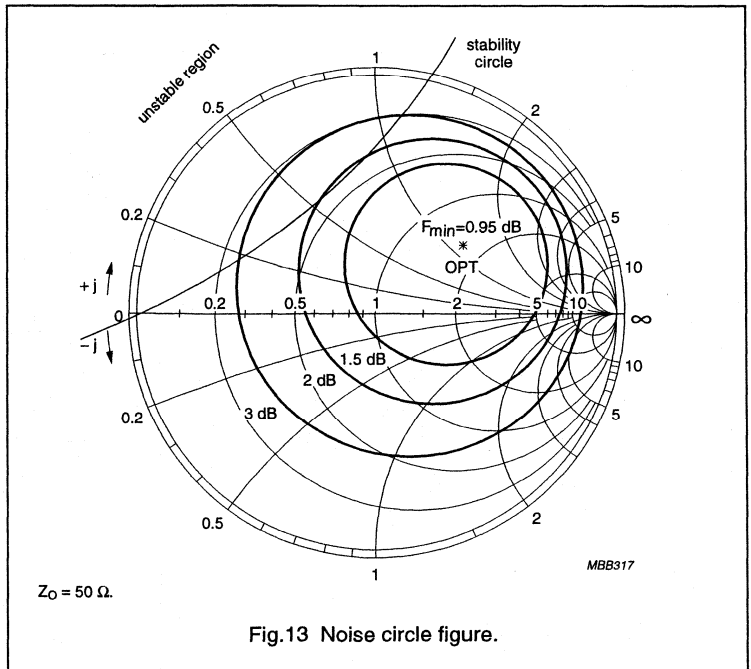


BFG67/X

| f (MHz) | V_{CE} (V) | I_C (mA) |
|---------|--------------|------------|
| 500 | 8 | 5 |

Noise Parameters

| F_{min} (dB) | Gamma (opt) | | $R_n/50$ |
|----------------|-------------|-------|----------|
| | (mag) | (ang) | |
| 0.95 | 0.455 | 33.8 | 0.288 |



NPN 8 GHz wideband transistor

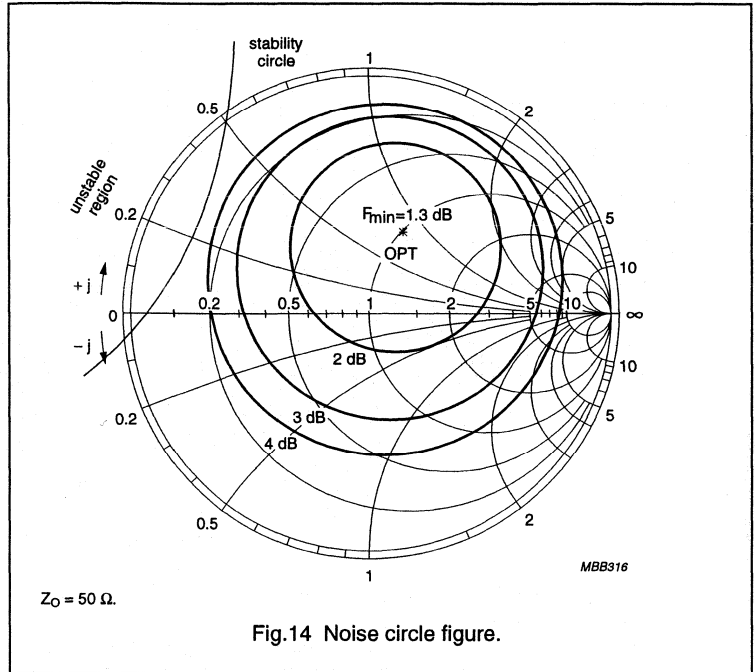
BFG67; BFG67/X;
BFG67R; BFG67XR

BFG67/X

| f (MHz) | V _{CE} (V) | I _C (mA) |
|------------|------------------------|------------------------|
| 1000 | 8 | 5 |

Noise Parameters

| F _{min} (dB) | Gamma (opt) | | R _n /50 |
|--------------------------|-------------|-------|--------------------|
| | (mag) | (ang) | |
| 1.3 | 0.375 | 65.9 | 0.304 |



BFG67/X

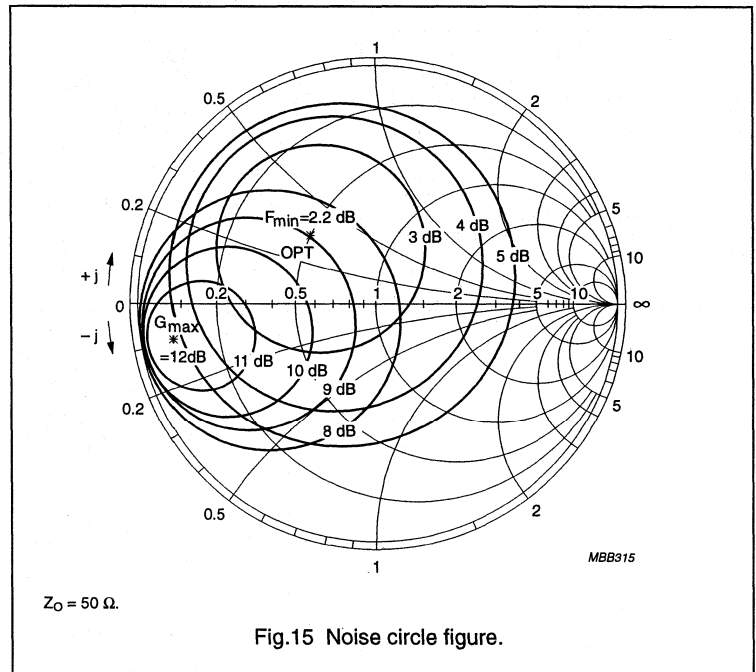
| f (MHz) | V _{CE} (V) | I _C (mA) |
|------------|------------------------|------------------------|
| 2000 | 8 | 5 |

Noise Parameters

| F _{min} (dB) | Gamma (opt) | | R _n /50 |
|--------------------------|-------------|-------|--------------------|
| | (mag) | (ang) | |
| 2.2 | 0.391 | 136.5 | 0.184 |

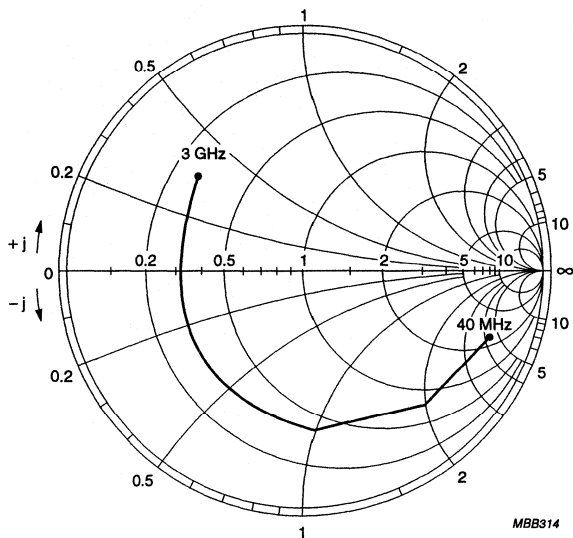
Average Gain Parameters

| G _{MAX} (dB) | Gamma (max) | |
|--------------------------|-------------|-------|
| | (mag) | (ang) |
| 12 | 0.839 | -170 |



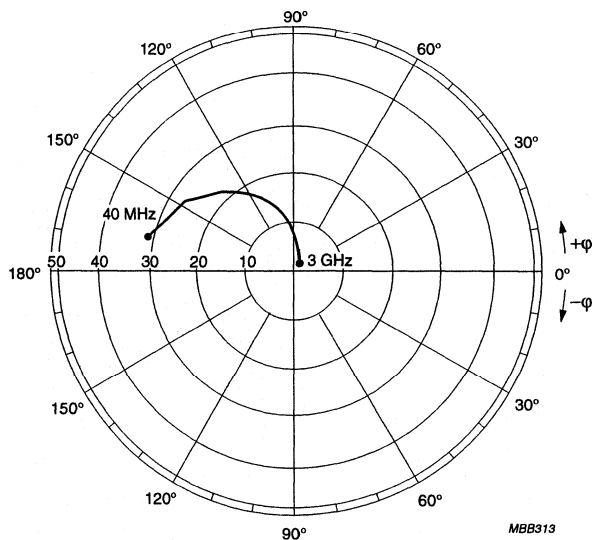
NPN 8 GHz wideband transistor

BFG67; BFG67/X;
BFG67R; BFG67/XR



$V_{CE} = 8\text{ V}; I_C = 15\text{ mA}; Z_O = 50\ \Omega.$

Fig.16 Common emitter input reflection coefficient (S_{11}).

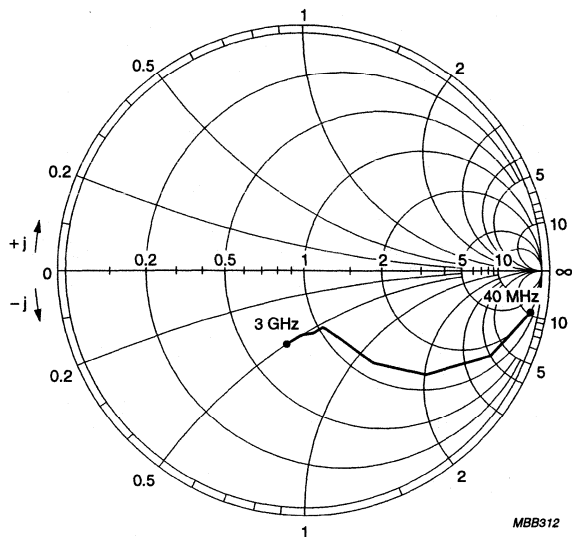


$V_{CE} = 8\text{ V}; I_C = 15\text{ mA}; Z_O = 50\ \Omega.$

Fig.17 Common emitter forward transmission coefficient (S_{21}).

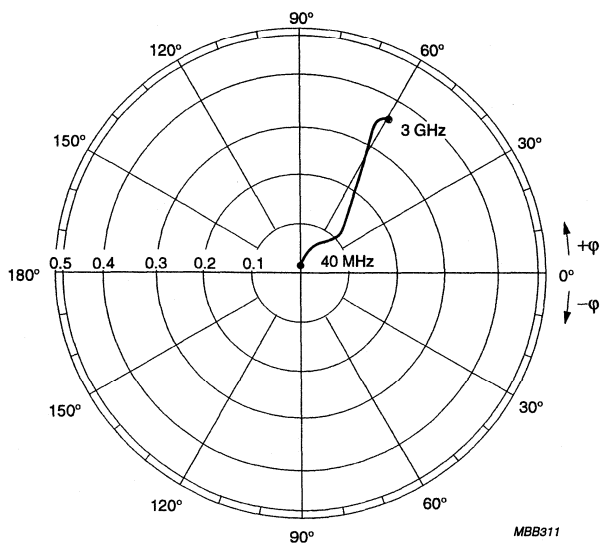
NPN 8 GHz wideband transistor

BFG67; BFG67/X;
BFG67R; BFG67/XR



$V_{CE} = 8 \text{ V}; I_C = 15 \text{ mA}$.

Fig.18 Common emitter reverse transmission coefficient (S_{12}).

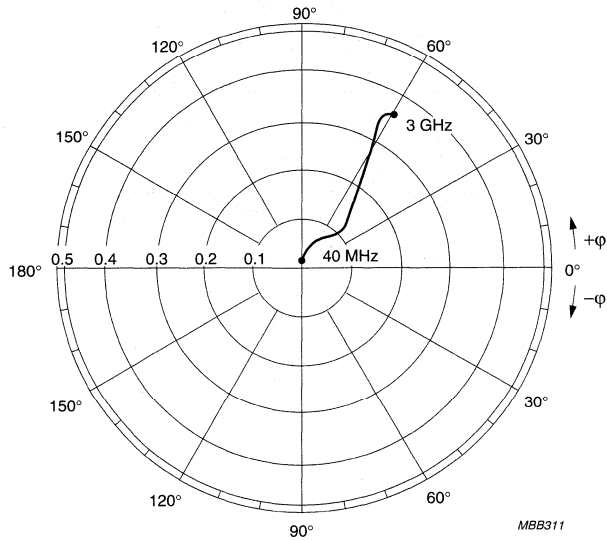


$V_{CE} = 8 \text{ V}; I_C = 15 \text{ mA}$.

Fig.19 Common emitter output reflection coefficient (S_{22}).

NPN 8 GHz wideband transistor

BFG67; BFG67/X;
BFG67R; BFG67/XR



$V_{CE} = 8 \text{ V}; I_C = 15 \text{ mA}$.

Fig.35 Common emitter output reflection coefficient (S_{22}).

NPN 5 GHz wideband transistors

BFG92A; BFG92A/X;
BFG92A/XR

FEATURES

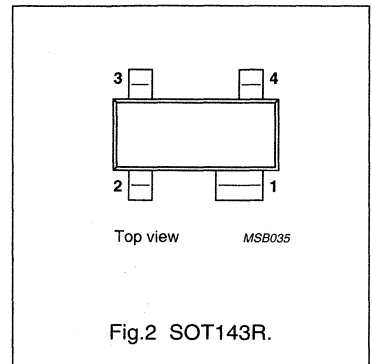
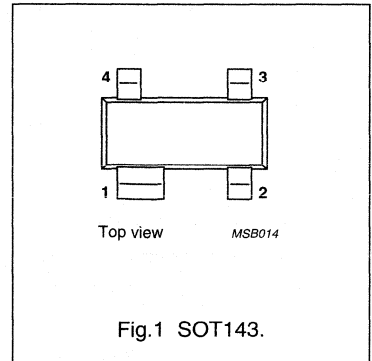
- High power gain
- Low noise figure
- Gold metallization ensures excellent reliability.

DESCRIPTION

The BFG92 is a silicon NPN transistor in a 4-pin, dual-emitter plastic SOT143 envelope. It is primarily intended for wideband applications in the UHF and microwave range.

PINNING

| PIN | DESCRIPTION |
|-----------------------------|-------------|
| BFG92A (Fig.1) Code: P8 | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG92A/X (Fig.1) Code: V14 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG92A/XR (Fig.2) Code: V29 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | | – | – | 15 | V |
| I_C | collector current | DC value | – | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_S = 60\text{ }^\circ\text{C}$; note 1 | – | – | 400 | mW |
| C_{re} | feedback capacitance | $I_C = I_c = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.35 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 16 | – | dB |
| | | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 11 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 2.0 | – | dB |

Note

1. T_S is the temperature at the soldering point of the collector tab.

NPN 5 GHz wideband transistors

BFG92A; BFG92A/X;
BFG92A/XR

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | collector current | DC value, continuous | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_S = 60\text{ °C}$; note 1 | – | 400 | mW |
| T_{stg} | storage temperature range | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|--|-------|------|
| $R_{th\ j-s}$ | from junction to soldering point; note 1 | 290 | K/W |

Note

- T_S is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

 $T_j = 25\text{ °C}$ unless otherwise specified.

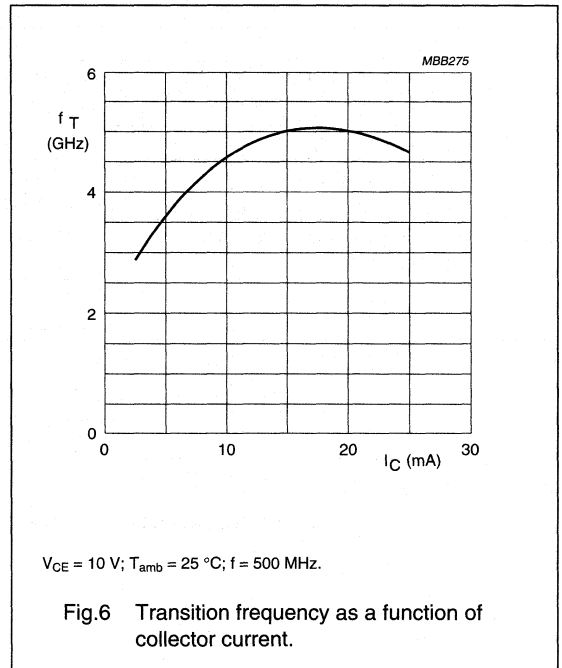
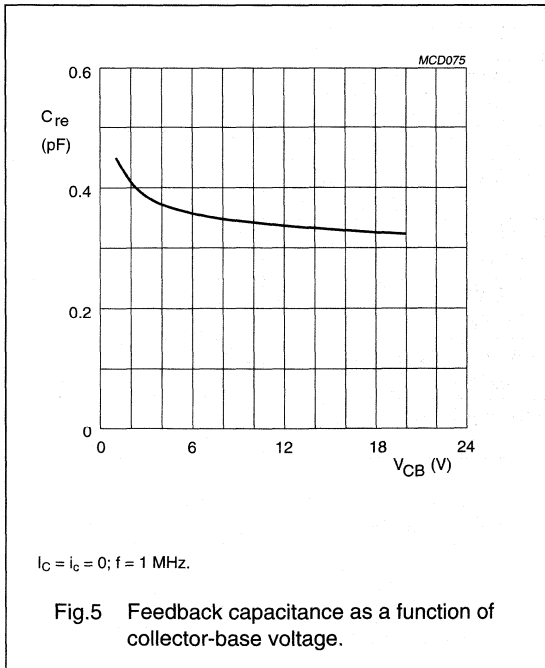
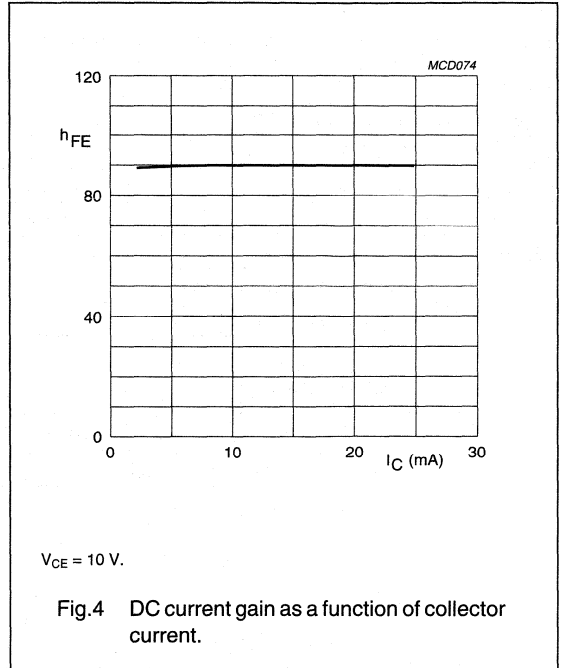
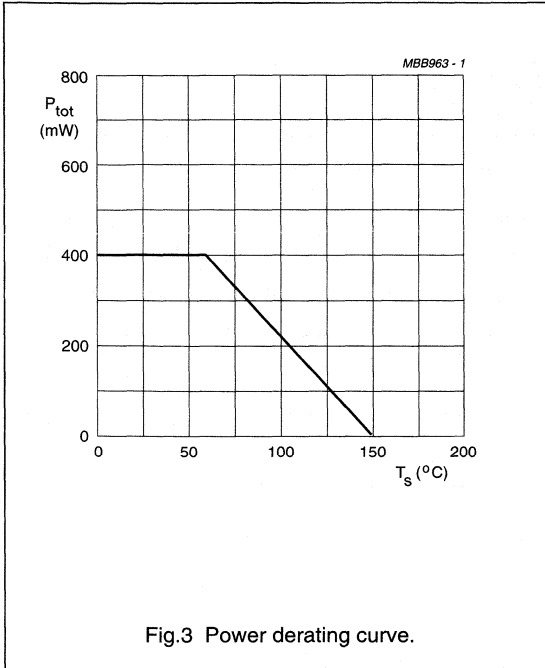
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------------------|---|------|------|------|------|
| I_{CBO} | collector leakage current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$ | 40 | 90 | – | |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.6 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.9 | – | pF |
| C_{re} | feedback capacitance | $I_C = i_c = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.35 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 1\text{ GHz}$ | – | 16 | – | dB |
| | | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 2\text{ GHz}$ | – | 11 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 1\text{ GHz}$ | – | 2.0 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 2\text{ GHz}$ | – | 3 | – | dB |

Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB.

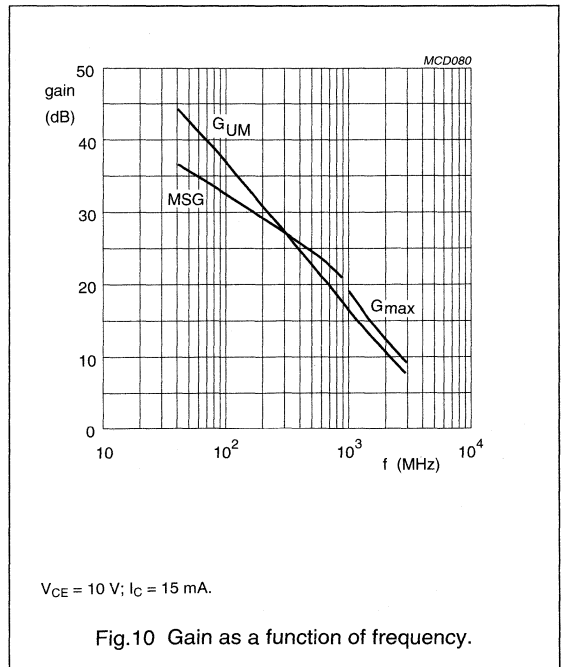
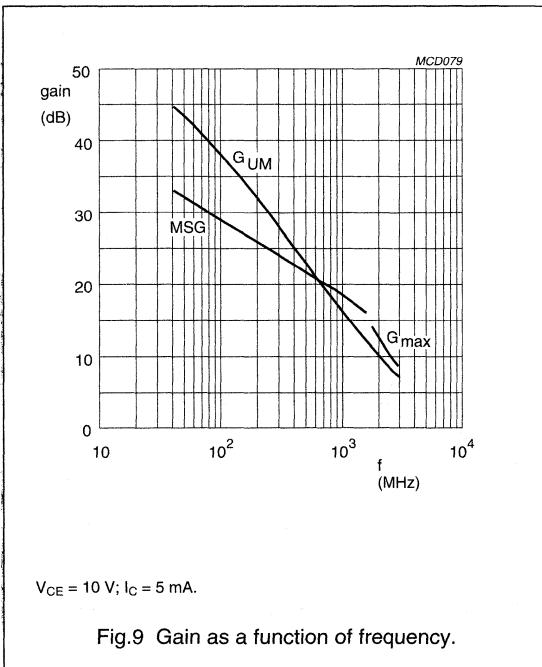
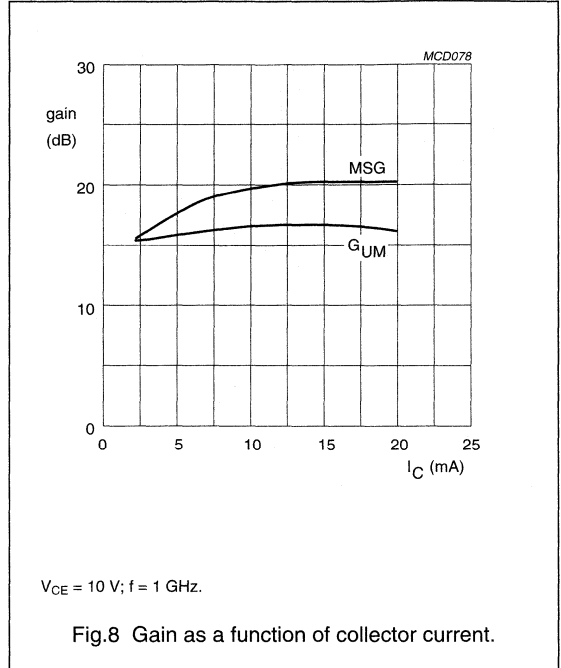
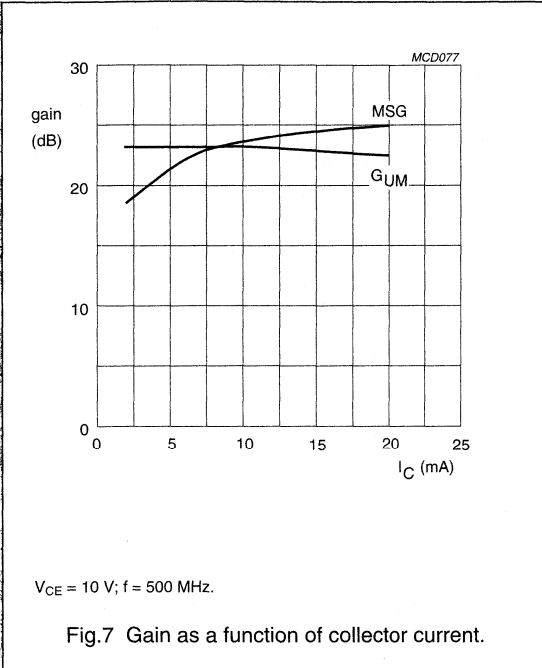
NPN 5 GHz wideband transistors

BFG92A; BFG92A/X;
BFG92A/XR



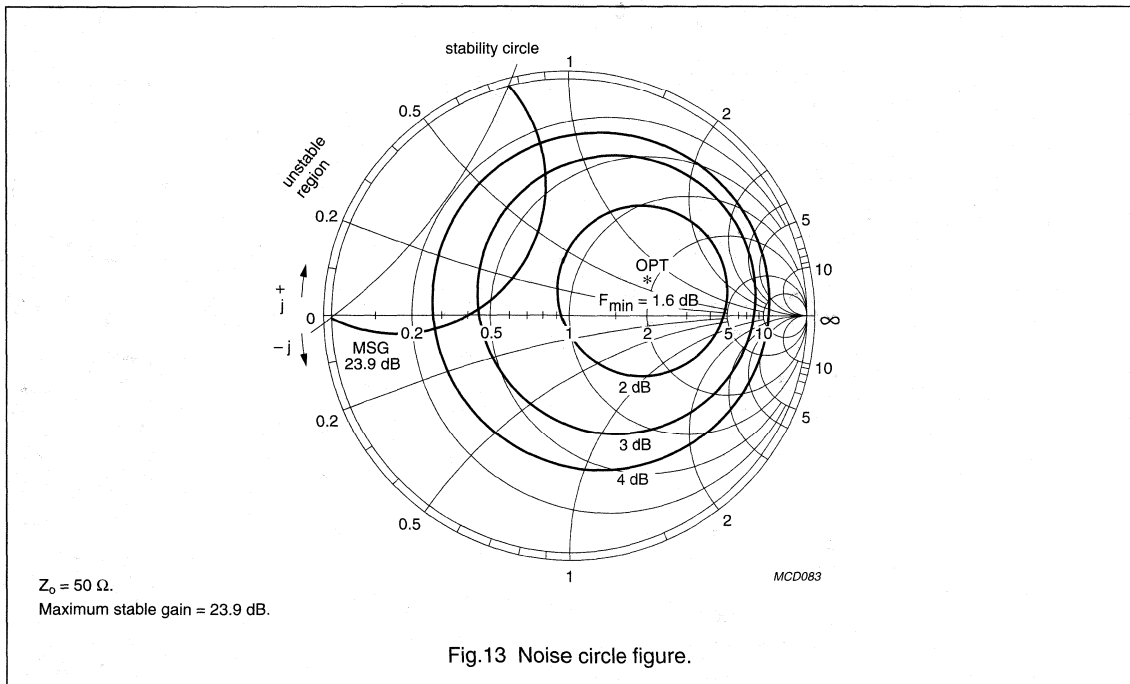
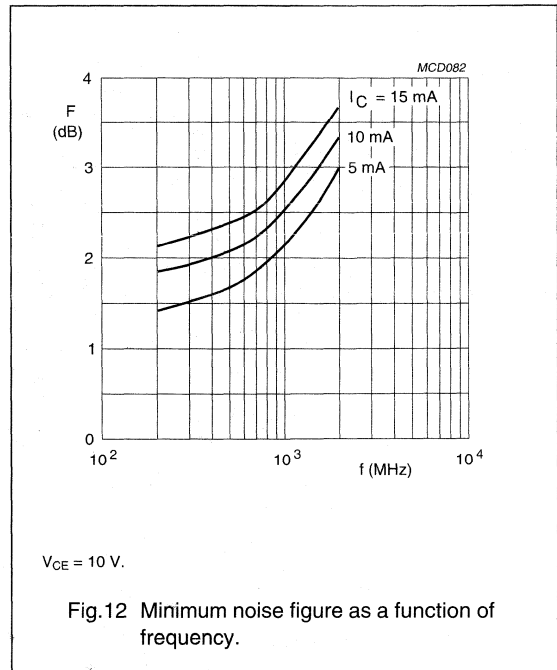
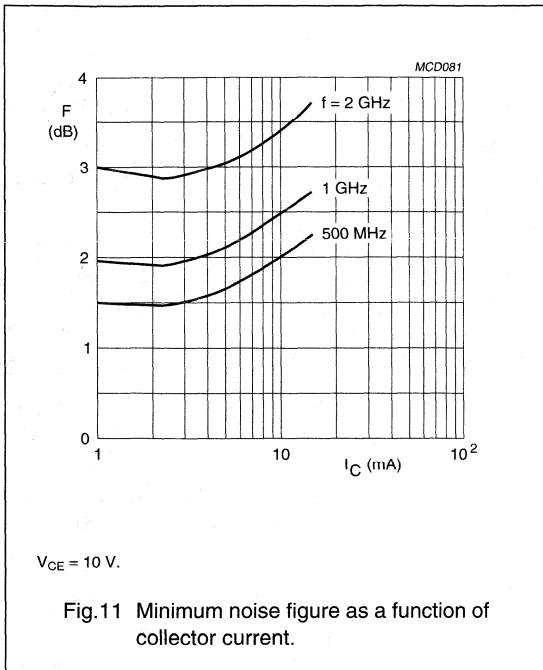
NPN 5 GHz wideband transistors

BFG92A; BFG92A/X;
BFG92A/XR



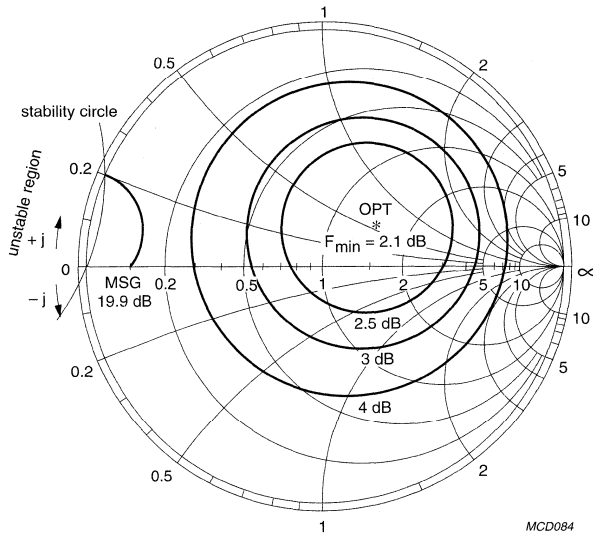
NPN 5 GHz wideband transistors

BFG92A; BFG92A/X;
BFG92A/XR



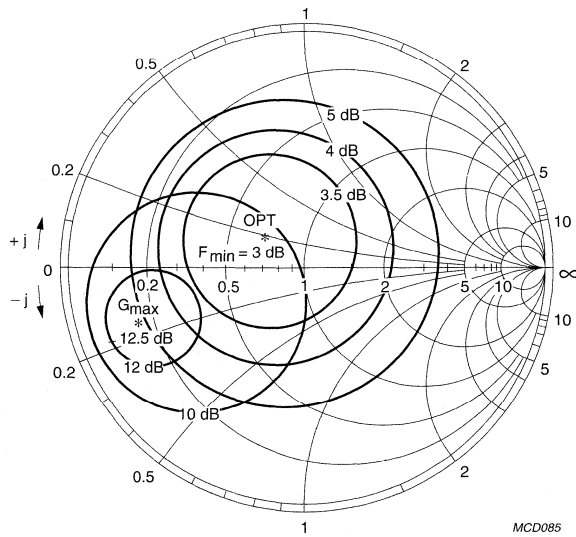
NPN 5 GHz wideband transistors

BFG92A; BFG92A/X;
BFG92A/XR



$Z_0 = 50 \Omega$.
Maximum stable gain = 19.9 dB.

Fig.14 Noise circle figure.

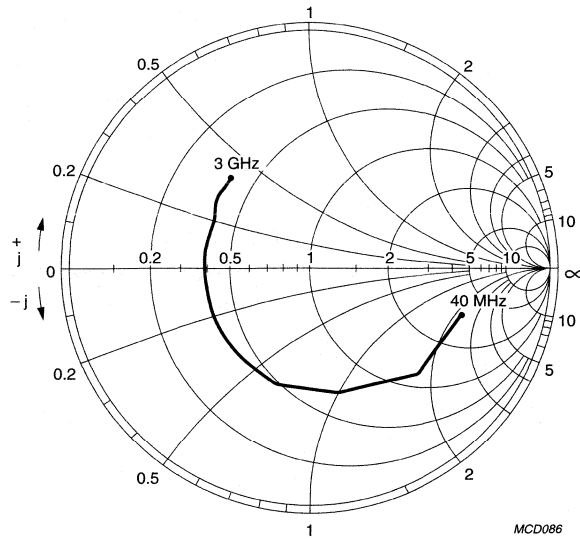


$Z_0 = 50 \Omega$.

Fig.15 Noise circle figure.

NPN 5 GHz wideband transistors

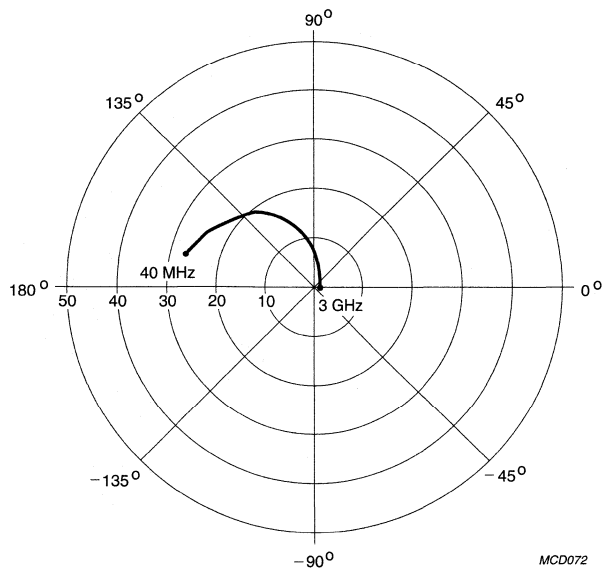
BFG92A; BFG92A/X;
BFG92A/XR



$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}$.

MCD086

Fig.16 Common emitter input reflection coefficient (S_{11}).



$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}$.

MCD072

Fig.17 Common emitter forward transmission coefficient (S_{21}).

NPN 5 GHz wideband transistors

BFG92A; BFG92A/X;
BFG92A/XR

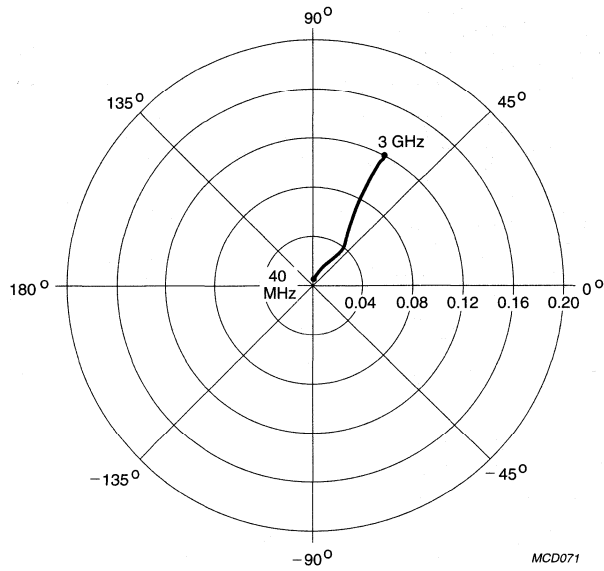


Fig.18 Common emitter reverse transmission coefficient (S_{12}).

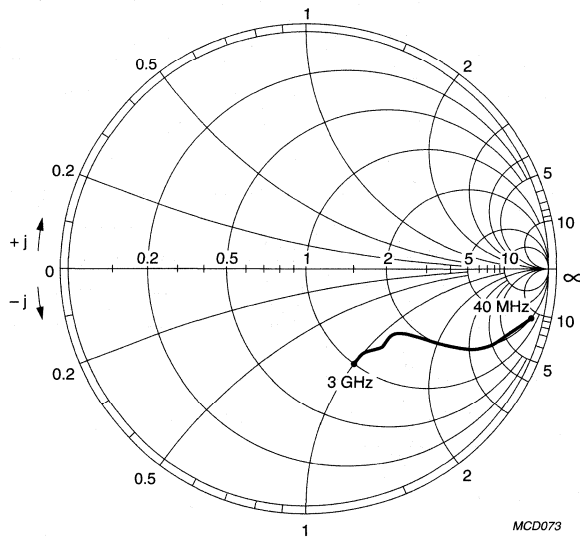


Fig.19 Common emitter output reflection coefficient (S_{22}).

NPN 5 GHz wideband transistors

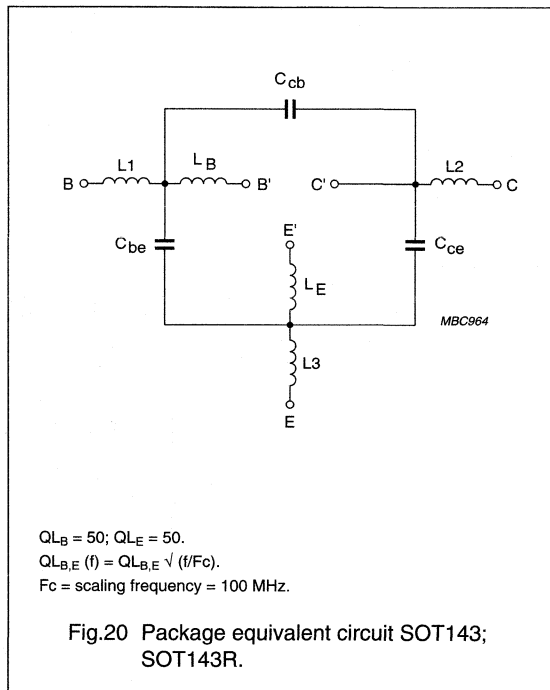
BFG92A; BFG92A/X;
BFG92A/XR

SPICE parameters for BFR90A crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|----------|
| 1 | IS | 411.8 | aA |
| 2 | BF | 102.6 | – |
| 3 | NF | 997.2 | m |
| 4 | VAF | 62.67 | V |
| 5 | IKF | 3.200 | A |
| 6 | ISE | 4.010 | fA |
| 7 | NE | 1.577 | – |
| 8 | BR | 18.10 | – |
| 9 | NR | 996.2 | m |
| 10 | VAR | 3.369 | V |
| 11 | IKR | 1.281 | A |
| 12 | ISC | 279.9 | aA |
| 13 | NC | 1.075 | – |
| 14 | RB | 10.00 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 10.00 | Ω |
| 17 | RE | 1.164 | Ω |
| 18 | RC | 2.320 | Ω |
| 19 (note 1) | XTB | 0.000 | – |
| 20 (note 1) | EG | 1.110 | EV |
| 21 (note 1) | XTI | 3.000 | – |
| 22 | CJE | 890.5 | fF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 258.5 | m |
| 25 | TF | 15.49 | ps |
| 26 | XTF | 39.14 | – |
| 27 | VTF | 2.152 | V |
| 28 | ITF | 213.7 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 546.5 | fF |
| 31 | VJC | 380.8 | mV |
| 32 | MJC | 202.9 | m |
| 33 | XCJC | 150.0 | m |
| 34 | TR | 5.618 | ns |
| 35 (note 1) | CJS | 0.000 | F |
| 36 (note 1) | VJS | 750.0 | mV |
| 37 (note 1) | MJS | 0.000 | – |
| 38 | FC | 850.0 | m |

Note

1. These parameters have not been extracted, the default values are shown.



List of components (see Fig.20)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 84 | fF |
| C_{cb} | 17 | fF |
| C_{ce} | 191 | fF |
| L1 | 0.12 | nH |
| L2 | 0.21 | nH |
| L3 | 0.06 | nH |
| L_B | 0.95 | nH |
| L_E | 0.40 | nH |

NPN 6 GHz wideband transistors

BFG93A; BFG93A/X; BFG93A/XR

FEATURES

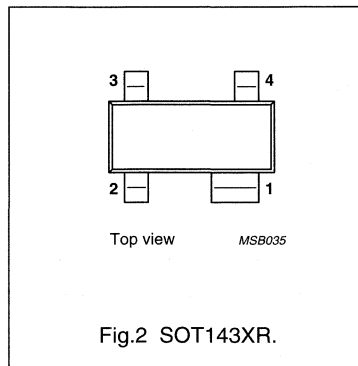
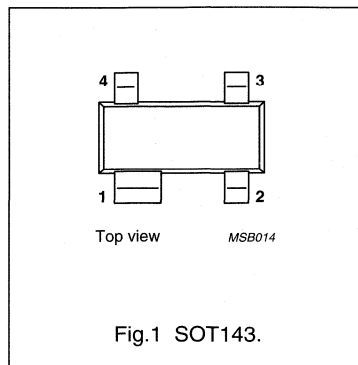
- High power gain
- Low noise figure
- Gold metallization ensures excellent reliability.

DESCRIPTION

The BFG93 is a silicon NPN transistor in a 4-pin, dual-emitter plastic SOT143 envelope. It is primarily intended for wideband applications in the UHF and microwave range.

PINNING

| PIN | DESCRIPTION |
|-----------------------------|-------------|
| BFG93A (Fig.1) Code: R8 | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG93A/X (Fig.1) Code: V15 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG93A/XR (Fig.2) Code: V33 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 12 | V |
| I_C | collector current | DC value | – | – | 35 | mA |
| P_{tot} | total power dissipation | up to $T_S = 85\text{ }^\circ\text{C}$; note 1 | – | – | 300 | mW |
| C_{re} | feedback capacitance | $I_C = i_c = 0$; $V_{CB} = 5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.6 | – | pF |
| f_T | transition frequency | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$ | 4.5 | 6 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 16 | – | dB |
| | | $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 10 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 1.7 | – | dB |

Note

1. T_S is the temperature at the soldering point of the collector tab.

NPN 6 GHz wideband transistors

BFG93A; BFG93A/X;
BFG93A/XR

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|--------------------------------|--------------------------------------|------|------|------|
| V _{CB0} | collector-base voltage | open emitter | – | 15 | V |
| V _{CEO} | collector-emitter voltage | open base | – | 12 | V |
| V _{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I _C | collector current | DC value, continuous | – | 35 | mA |
| P _{tot} | total power dissipation | up to T _S = 85 °C; note 1 | – | 300 | mW |
| T _{stg} | storage temperature range | | –65 | +150 | °C |
| T _j | junction operating temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------------|--|-------|------|
| R _{th j-s} | from junction to soldering point; note 1 | 290 | K/W |

Note

1. T_S is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

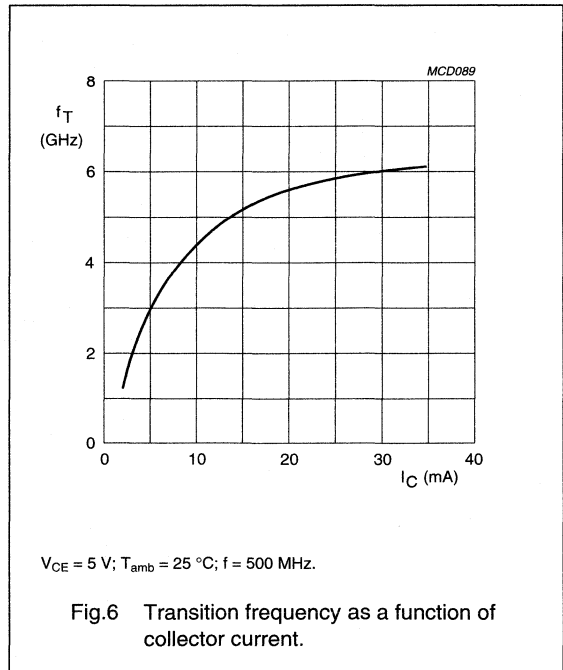
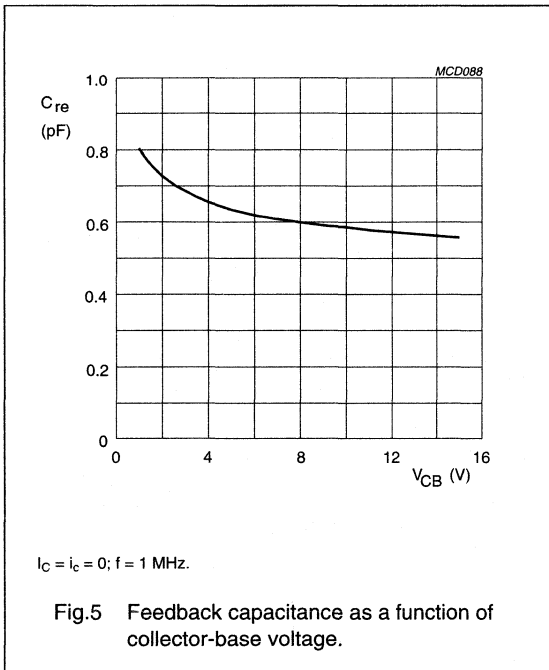
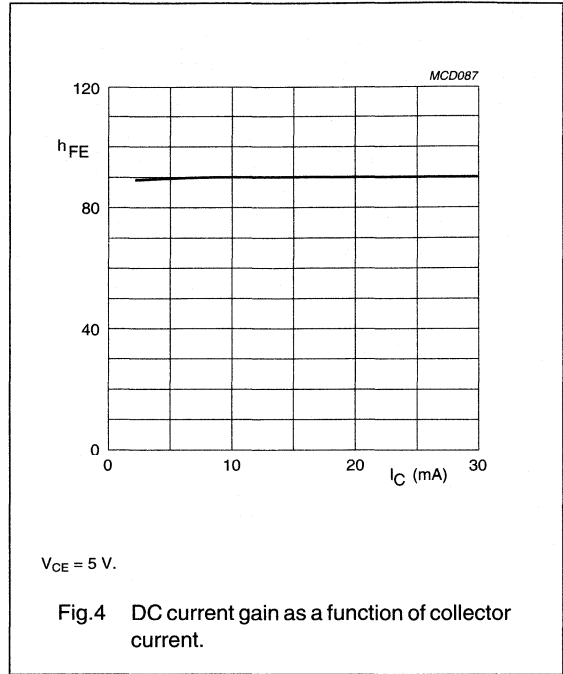
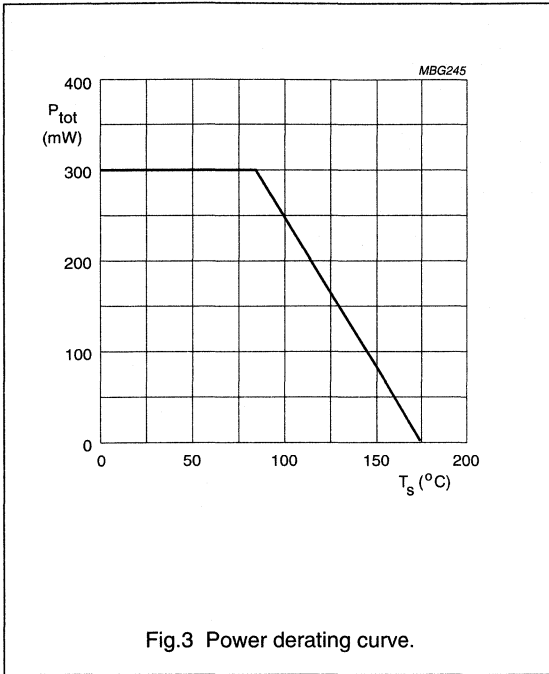
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------|---------------------------------------|--|------|------|------|------|
| I _{CBO} | collector leakage current | I _E = 0; V _{CB} = 5 V | – | – | 50 | nA |
| h _{FE} | DC current gain | I _C = 30 mA; V _{CE} = 5 V | 40 | 90 | – | |
| C _c | collector capacitance | I _E = i _e = 0; V _{CB} = 5 V; f = 1 MHz | – | 0.9 | – | pF |
| C _e | emitter capacitance | I _C = i _c = 0; V _{EB} = 5 V; f = 1 MHz | – | 1.9 | – | pF |
| C _{re} | feedback capacitance | I _C = i _c = 0; V _{CB} = 5 V; f = 1 MHz | – | 0.6 | – | pF |
| f _T | transition frequency | I _C = 30 mA; V _{CE} = 5 V; f = 500 MHz | 4.5 | 6 | – | GHz |
| G _{UM} | maximum unilateral power gain; note 1 | I _C = 30 mA; V _{CE} = 8 V; T _{amb} = 25 °C; f = 1 GHz | – | 16 | – | dB |
| | | I _C = 30 mA; V _{CE} = 8 V; T _{amb} = 25 °C; f = 2 GHz | – | 10 | – | dB |
| F | noise figure | Γ _s = Γ _{opt} ; I _C = 5 mA; V _{CE} = 8 V; T _{amb} = 25 °C; f = 1 GHz | – | 1.7 | – | dB |
| | | Γ _s = Γ _{opt} ; I _C = 5 mA; V _{CE} = 8 V; T _{amb} = 25 °C; f = 2 GHz | – | 2.3 | – | dB |

Note

1. G_{UM} is the maximum unilateral power gain, assuming S₁₂ is zero and $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

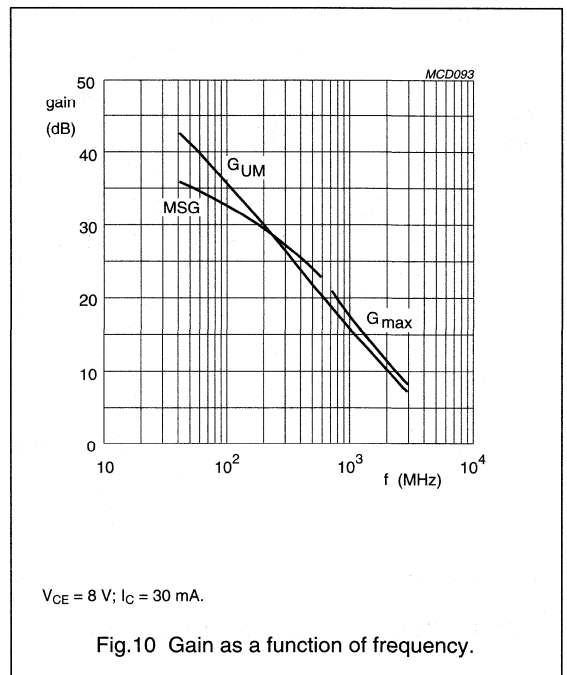
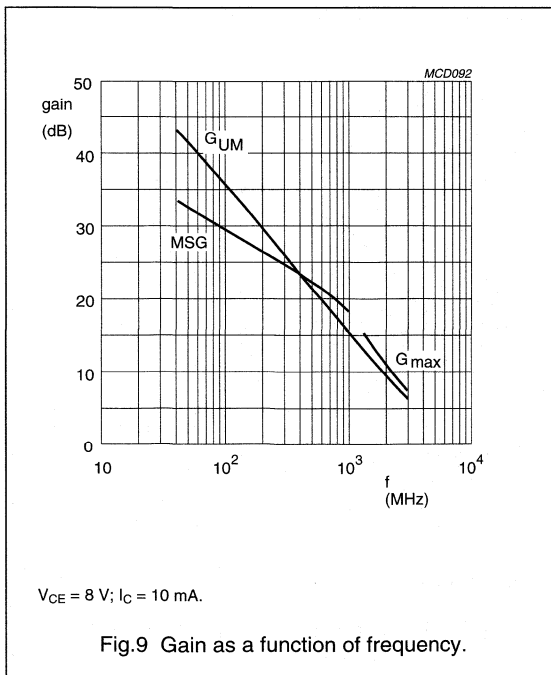
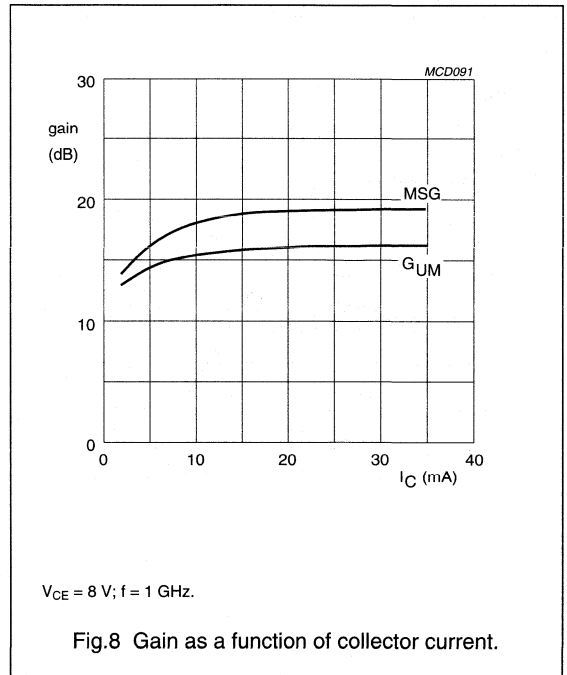
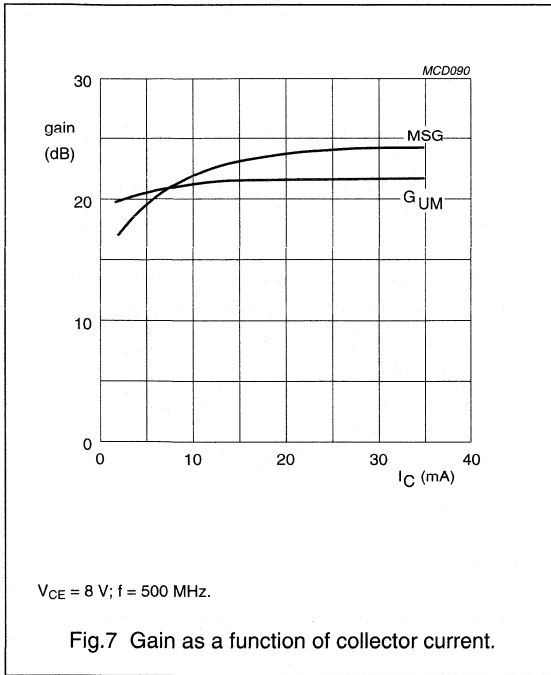
NPN 6 GHz wideband transistors

BFG93A; BFG93A/X;
BFG93A/XR



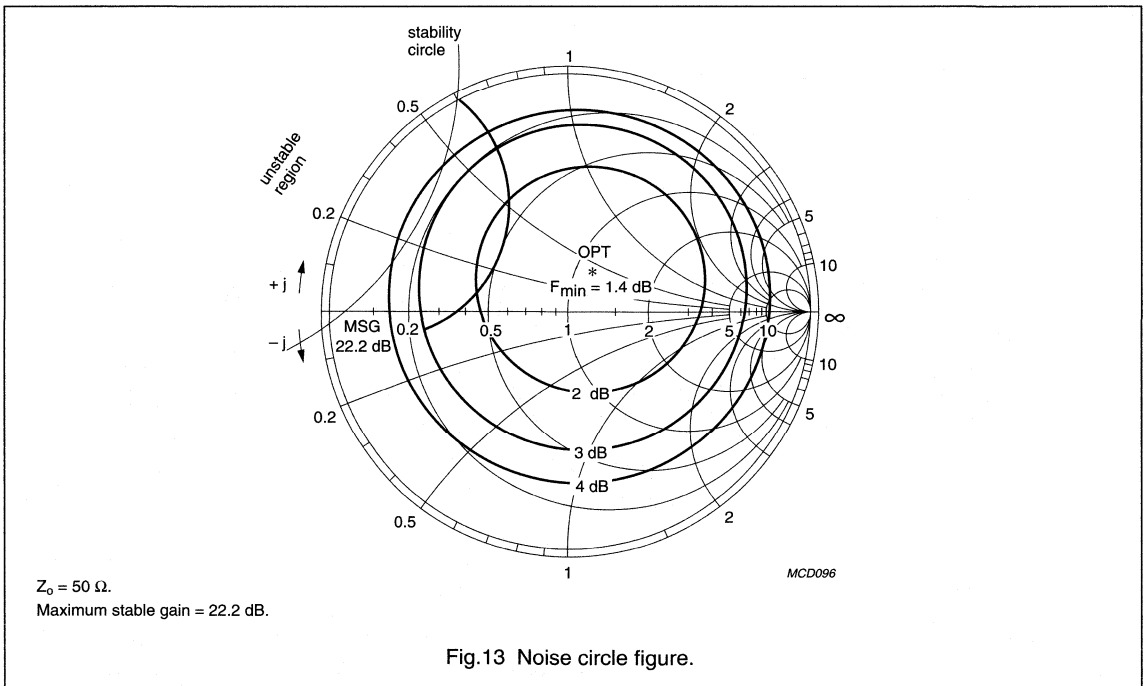
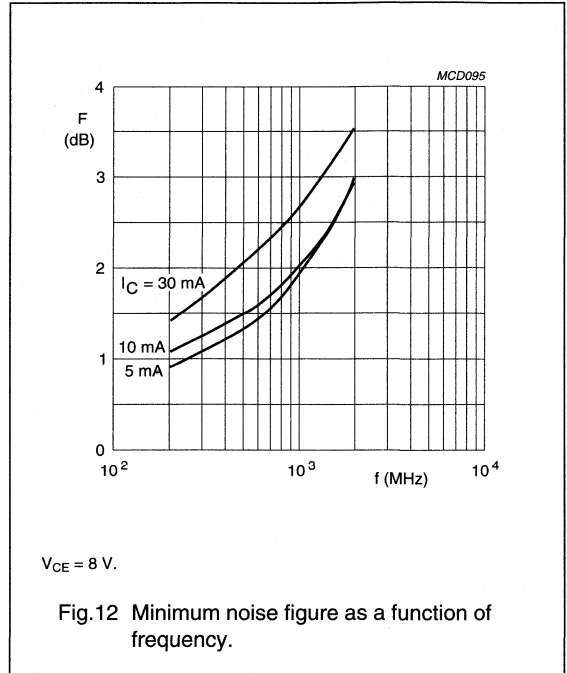
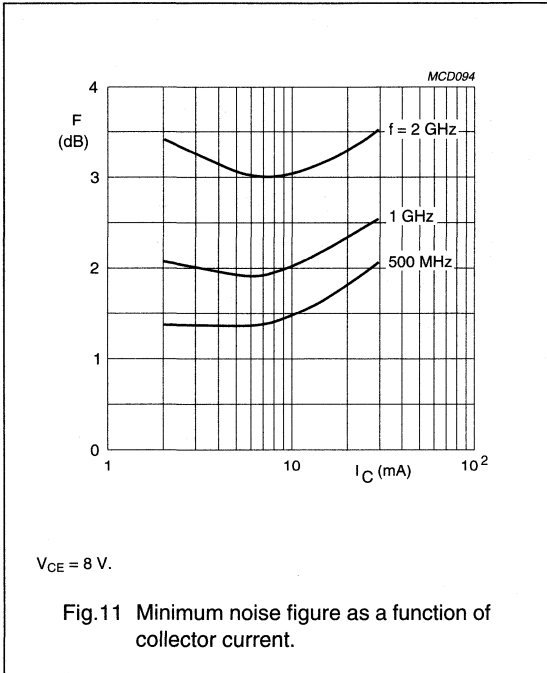
NPN 6 GHz wideband transistors

BFG93A; BFG93A/X;
BFG93A/XR



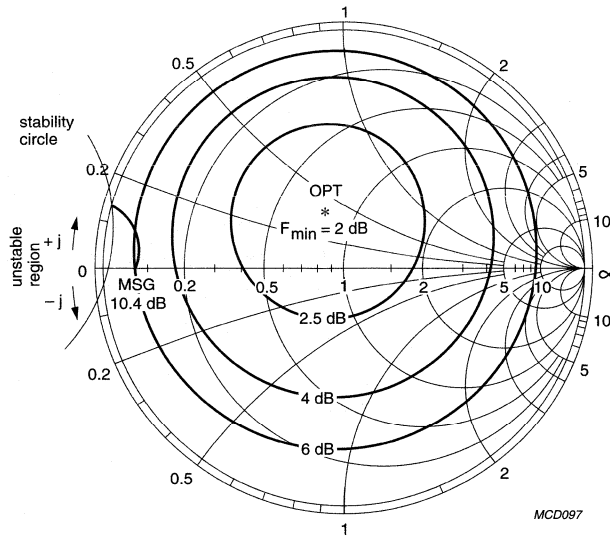
NPN 6 GHz wideband transistors

BFG93A; BFG93A/X;
BFG93A/XR



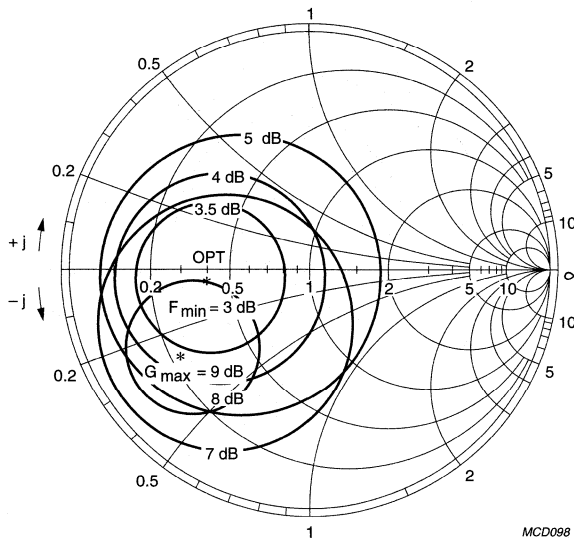
NPN 6 GHz wideband transistors

BFG93A; BFG93A/X;
BFG93A/XR



$Z_0 = 50 \Omega$.
Maximum stable gain = 10.4 dB.

Fig.14 Noise circle figure.

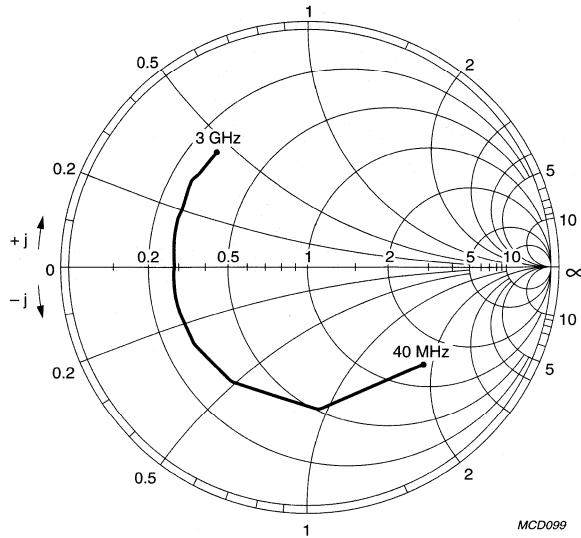


$Z_0 = 50 \Omega$.

Fig.15 Noise circle figure.

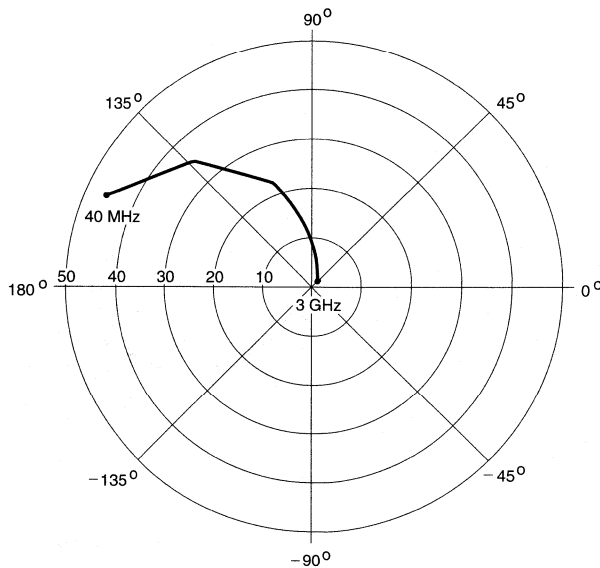
NPN 6 GHz wideband transistors

BFG93A; BFG93A/X;
BFG93A/XR



$V_{CE} = 8 \text{ V}; I_C = 30 \text{ mA}; Z_o = 50 \Omega.$

Fig.16 Common emitter input reflection coefficient (S_{11}).

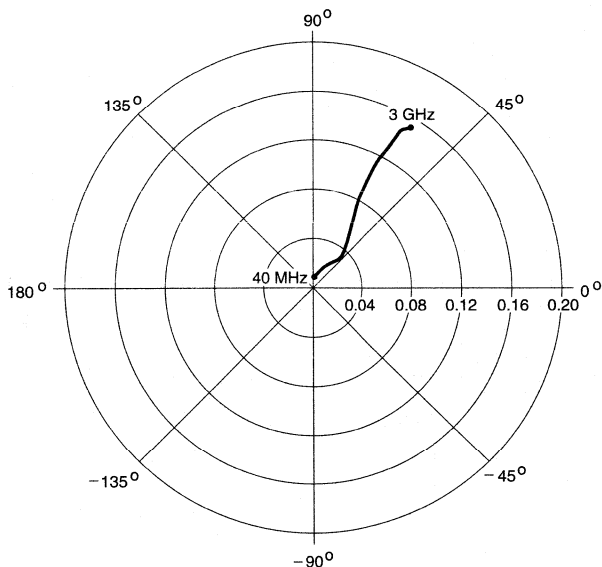


$V_{CE} = 8 \text{ V}; I_C = 30 \text{ mA}; R_{max} = 50 \Omega$

Fig.17 Common emitter forward transmission coefficient (S_{21}).

NPN 6 GHz wideband transistors

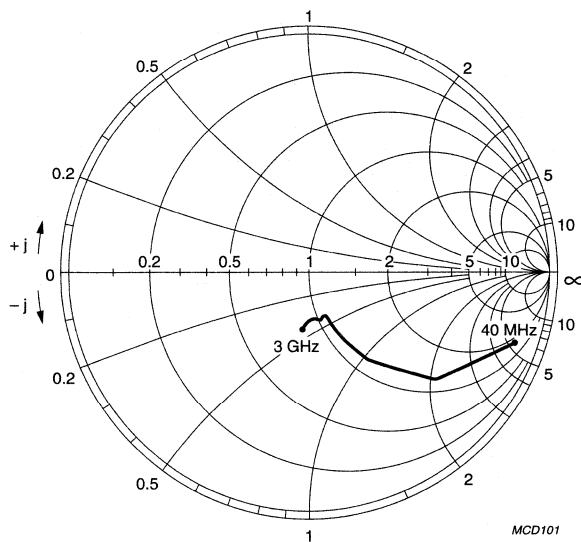
BFG93A; BFG93A/X;
BFG93A/XR



$V_{CE} = 8 \text{ V}; I_C = 30 \text{ mA}; R_{max} = 0.2 \Omega$

MCD102

Fig.18 Common emitter reverse transmission coefficient (S_{12}).



$V_{CE} = 10 \text{ V}; I_C = 15 \text{ mA}; Z_o = 50 \Omega$.

MCD101

Fig.19 Common emitter output reflection coefficient (S_{22}).

NPN 6 GHz wideband transistors

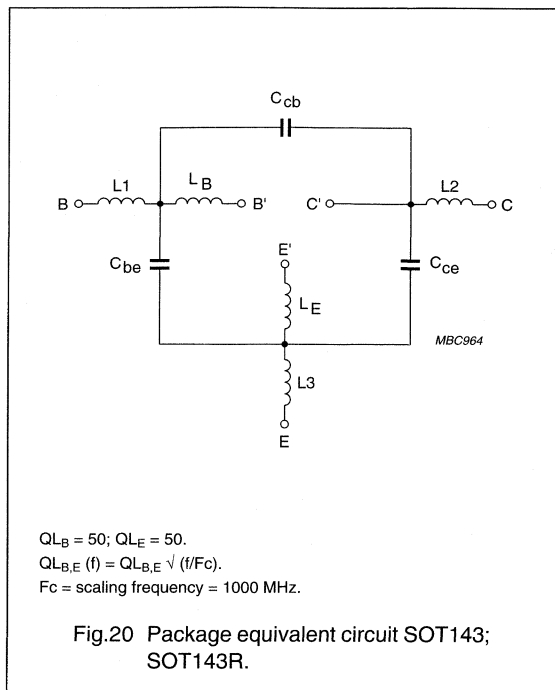
BFG93A; BFG93A/X;
BFG93A/XR

SPICE parameters for BFR91A crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|------------|
| 1 | IS | 1.328 | fA |
| 2 | BF | 102.0 | – |
| 3 | NF | 1.000 | – |
| 4 | VAF | 51.90 | V |
| 5 | IKF | 8.155 | A |
| 6 | ISE | 13.90 | fA |
| 7 | NE | 15.12 | – |
| 8 | BR | 17.69 | – |
| 9 | NR | 994.0 | m |
| 10 | VAR | 3.280 | V |
| 11 | IKR | 10.00 | A |
| 12 | ISC | 1.043 | aA |
| 13 | NC | 1.189 | – |
| 14 | RB | 10.00 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 10.00 | Ω |
| 17 | RE | 763.6 | m Ω |
| 18 | RC | 9.000 | Ω |
| 19 (note 1) | XTB | 0.000 | – |
| 20 (note 1) | EG | 1.110 | EV |
| 21 (note 1) | XTI | 3.000 | – |
| 22 | CJE | 2.032 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 290.0 | m |
| 25 | TF | 6.557 | ps |
| 26 | XTF | 38.97 | – |
| 27 | VTF | 10.93 | V |
| 28 | ITF | 521.0 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 1.003 | pF |
| 31 | VJC | 340.8 | mV |
| 32 | MJC | 194.2 | m |
| 33 | XCJC | 120.0 | m |
| 34 | TR | 3.073 | ns |
| 35 (note 1) | CJS | 0.000 | F |
| 36 (note 1) | VJS | 750.0 | mV |
| 37 (note 1) | MJS | 0.000 | – |
| 38 | FC | 800.0 | m |

Note

1. These parameters have not been extracted, the default values are shown.



List of components (see Fig.20)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 84 | fF |
| C_{cb} | 17 | fF |
| C_{ce} | 191 | fF |
| L1 | 0.12 | nH |
| L2 | 0.21 | nH |
| L3 | 0.06 | nH |
| L_B | 0.95 | nH |
| L_E | 0.40 | nH |

NPN 6 GHz wideband transistor

BFG94

FEATURES

- High power gain
- Low noise figure
- Low intermodulation distortion
- Gold metallization ensures excellent reliability.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |

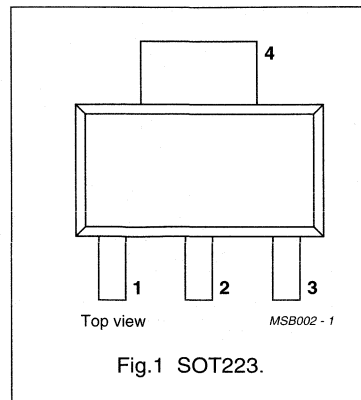


Fig.1 SOT223.

DESCRIPTION

NPN transistor mounted in a plastic SOT223 envelope. It is primarily intended for use in communication and instrumentation systems.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 12 | V |
| I_C | DC collector current | | – | – | 60 | mA |
| P_{tot} | total power dissipation | up to $T_s = 140\text{ °C}$ (note 1) | – | – | 700 | mW |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | – | 0.8 | pF |
| f_T | transition frequency | $I_C = 45\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | 4 | 6 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 45\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | 11.5 | 13.5 | – | dB |
| V_O | output voltage | $I_C = 45\text{ mA}$; $V_{CE} = 10\text{ V}$; $d_{im} = -60\text{ dB}$; $R_L = 75\text{ }\Omega$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 500 | – | mV |
| P_{L1} | output power at 1 dB gain compression | $I_C = 45\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 21.5 | – | dBm |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 6 GHz wideband transistor

BFG94

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 12 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 60 | mA |
| P_{tot} | total power dissipation | up to $T_s = 140\text{ °C}$ (note 1) | – | 700 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 140\text{ °C}$ (note 1) | 50 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 6 GHz wideband transistor

BFG94

CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------|--|---|------|------|------|------|
| I _{CBO} | collector cut-off current | I _E = 0; V _{CB} = 10 V | – | – | 100 | nA |
| h _{FE} | DC current gain | I _C = 30 mA; V _{CE} = 5 V | 45 | 90 | – | |
| | | I _C = 45 mA; V _{CE} = 10 V | – | 100 | – | |
| C _c | collector capacitance | I _E = I _e = 0; V _{CB} = 10 V; f = 1 MHz | – | 0.9 | 2 | pF |
| C _e | emitter capacitance | I _C = I _e = 0; V _{EB} = 0.5 V; f = 1 MHz | – | 2.9 | 4.5 | pF |
| C _{re} | feedback capacitance | I _C = I _c = 0; V _{CE} = 10 V; f = 1 MHz | – | 0.5 | 0.8 | pF |
| f _T | transition frequency | I _C = 45 mA; V _{CE} = 10 V; f = 1 GHz; T _{amb} = 25 °C | 4 | – | – | GHz |
| | | I _C = 30 mA; V _{CE} = 5 V; f = 1 GHz; T _{amb} = 25 °C | 4 | 6 | – | GHz |
| G _{UM} | maximum unilateral power gain (note1) | I _C = 45 mA; V _{CE} = 10 V; f = 1 GHz; T _{amb} = 25 °C | 11.5 | 13.5 | – | dB |
| F | minimum noise figure | Γ _s = Γ _{opt} ; I _C = 45 mA; V _{CE} = 10 V; f = 500 MHz | – | 2.7 | – | dB |
| | | Γ _s = Γ _{opt} ; I _C = 45 mA; V _{CE} = 10 V; f = 1 GHz | – | 3 | – | dB |
| V _O | output voltage | note 2 | – | 500 | – | mV |
| d ₂ | second order intermodulation distortion | note 3 | – | –51 | – | dB |
| P _{L1} | output power at 1 dB gain compression | I _C = 45 mA; V _{CE} = 10 V; R _L = 50 Ω; T _{amb} = 25 °C; measured at f = 1 GHz | – | 21.5 | – | dBm |
| ITO | third order intercept point | note 4 | – | 34 | – | dBm |

Notes

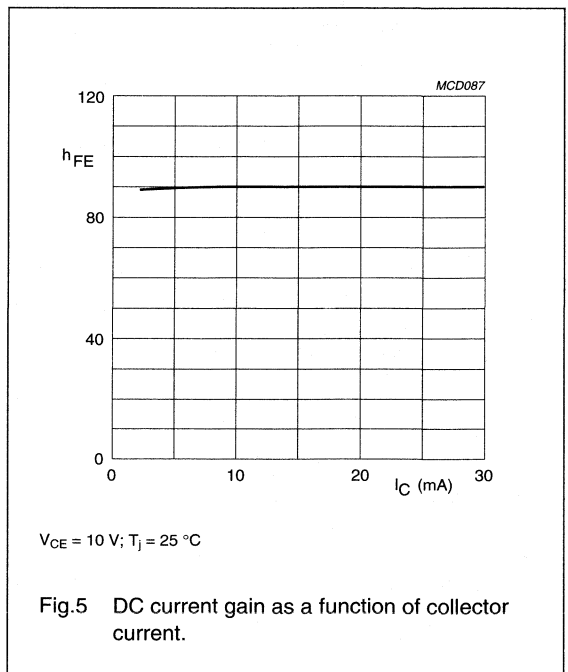
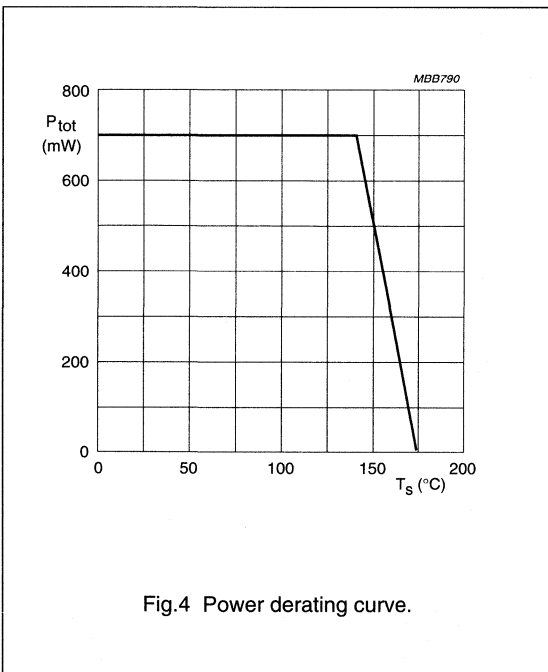
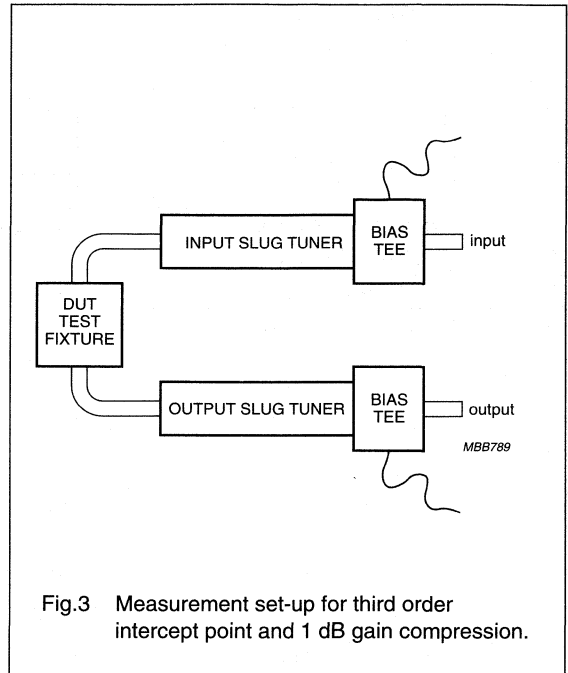
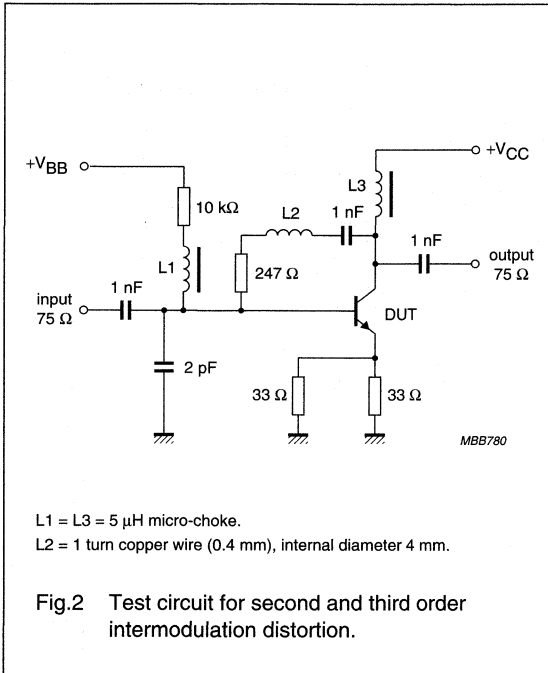
1. G_{UM} is the maximum unilateral power gain, assuming S₁₂ is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{dB.}$$

2. d_{im} = –60 dB (DIN 45004B, par 6.3: 3-tone); I_C = 45 mA; V_{CE} = 10 V; R_L = 75 Ω; T_{amb} = 25 °C;
V_p = V_O at d_{im} = –60 dB; f_p = 795.25 MHz;
V_q = V_O –6 dB; V_r = V_O –6 dB;
f_q = 803.25 MHz; f_r = 805.25 MHz;
measured at f_(p+q-r) = 793.25 MHz.
3. I_C = 45 mA; V_{CE} = 10 V; R_L = 75 Ω; T_{amb} = 25 °C;
V_q = V_O = 280 mV;
f_p = 250 MHz; f_q = 560 MHz;
measured at f_(p+q) = 810 MHz.
4. I_C = 45 mA; V_{CE} = 10 V; R_L = 50 Ω; T_{amb} = 25 °C;
f_p = 1000 MHz; f_q = 1001 MHz;
measured at f_(2p-q) and f_(2q-p).

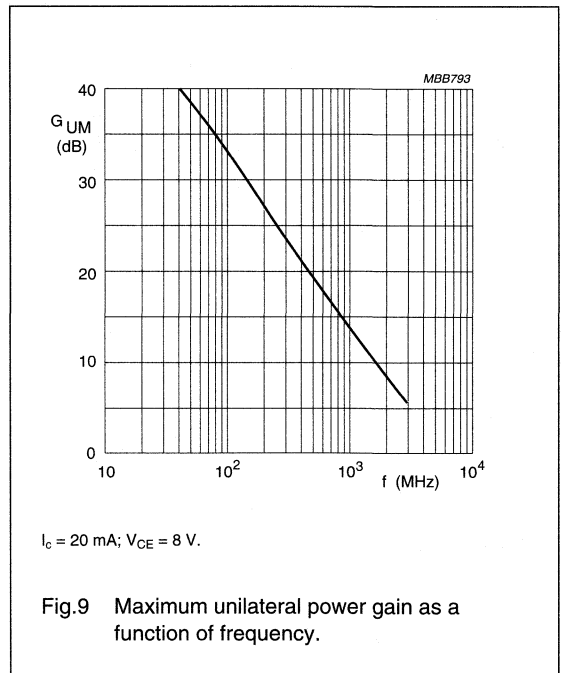
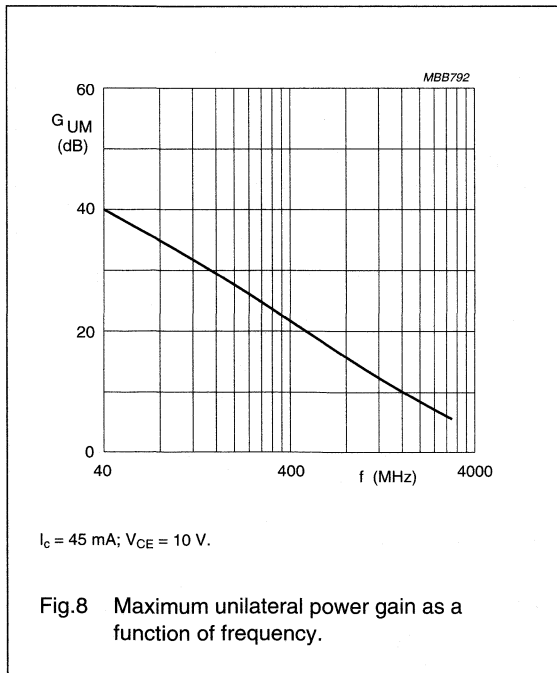
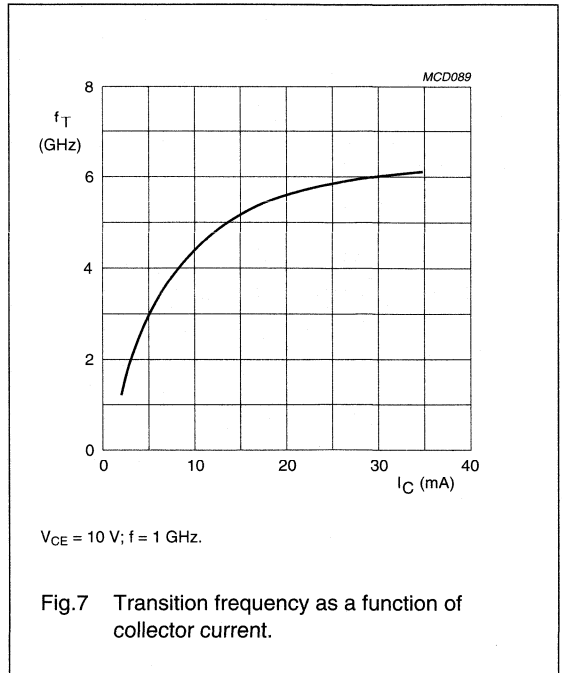
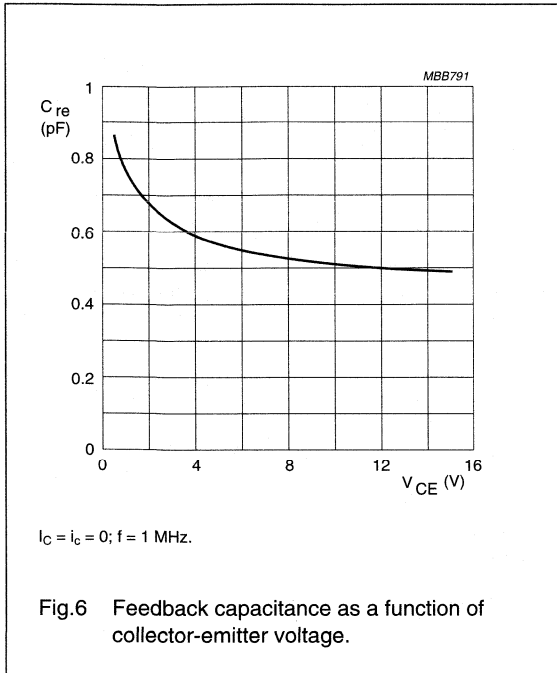
NPN 6 GHz wideband transistor

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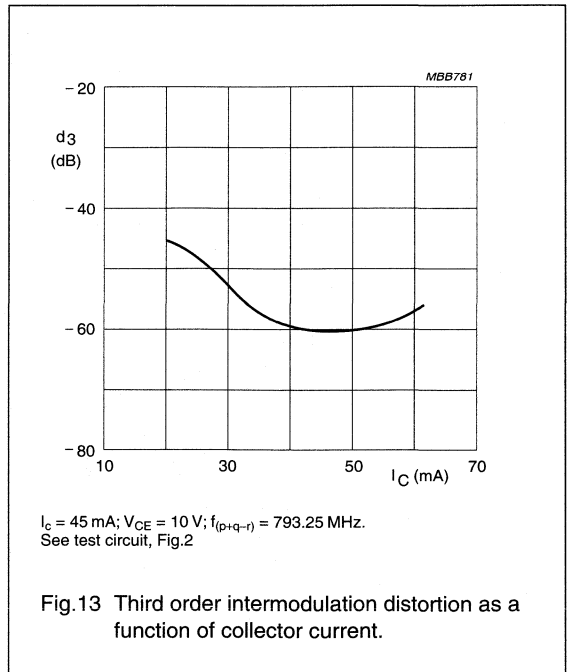
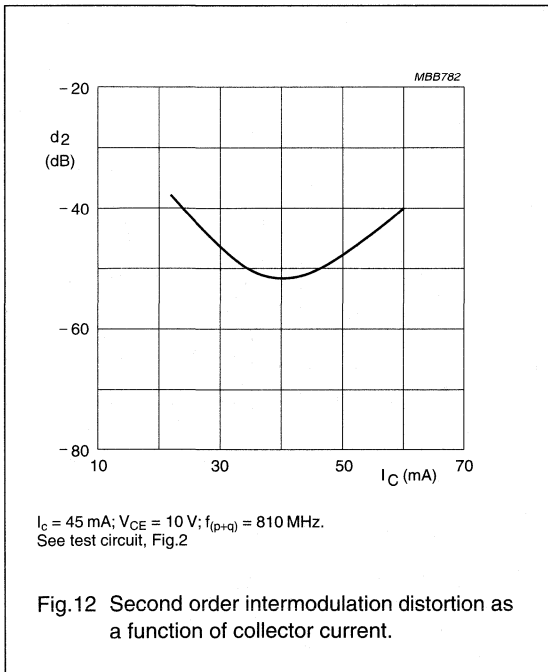
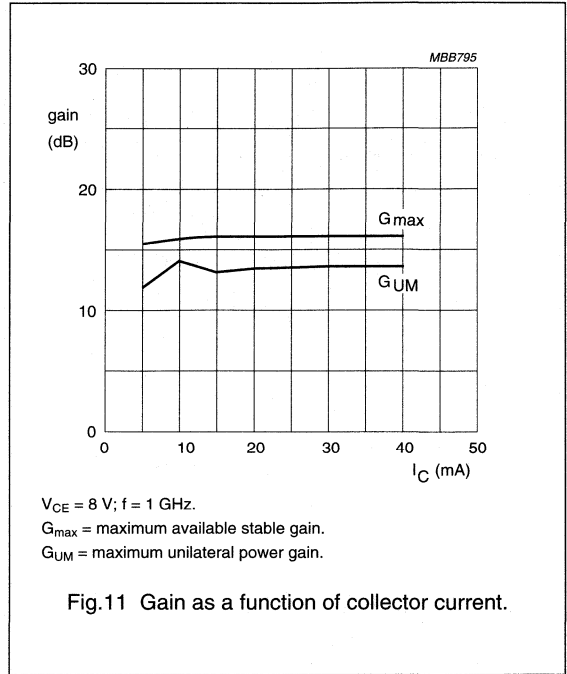
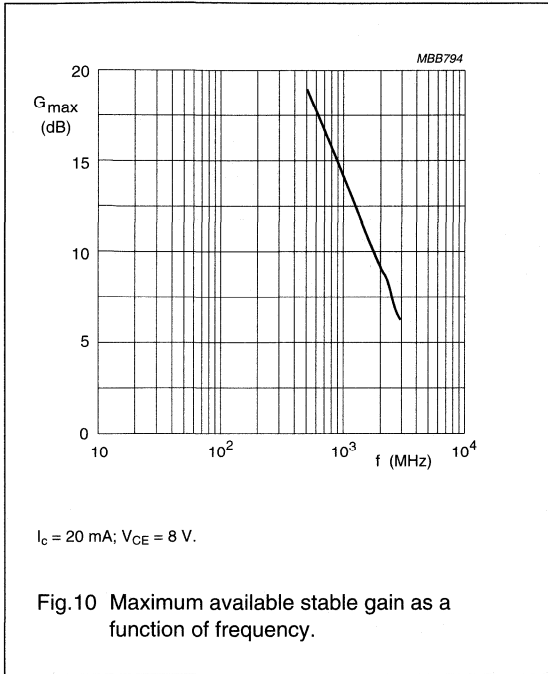
NPN 6 GHz wideband transistor

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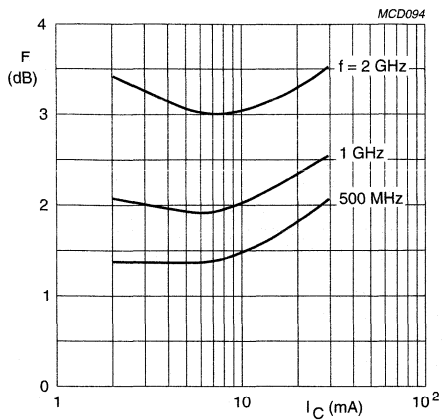
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NPN 6 GHz wideband transistor

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$V_{CE} = 8 \text{ V.}$

Fig.14 Minimum noise figure as a function of collector current.

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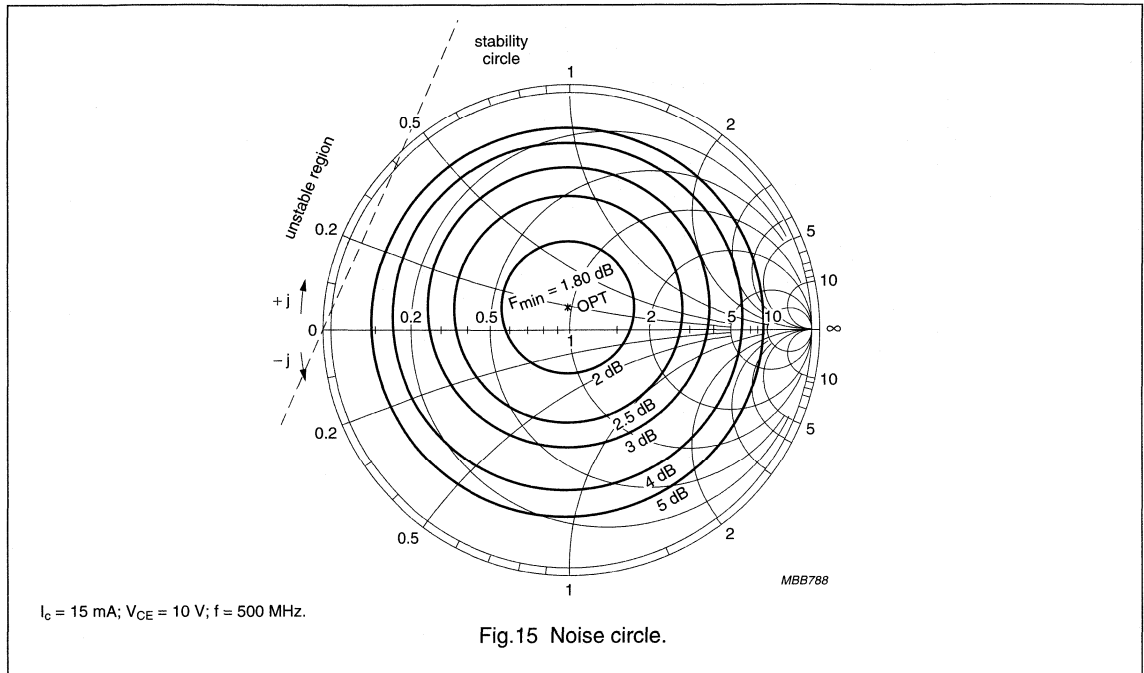


Fig.15 Noise circle.

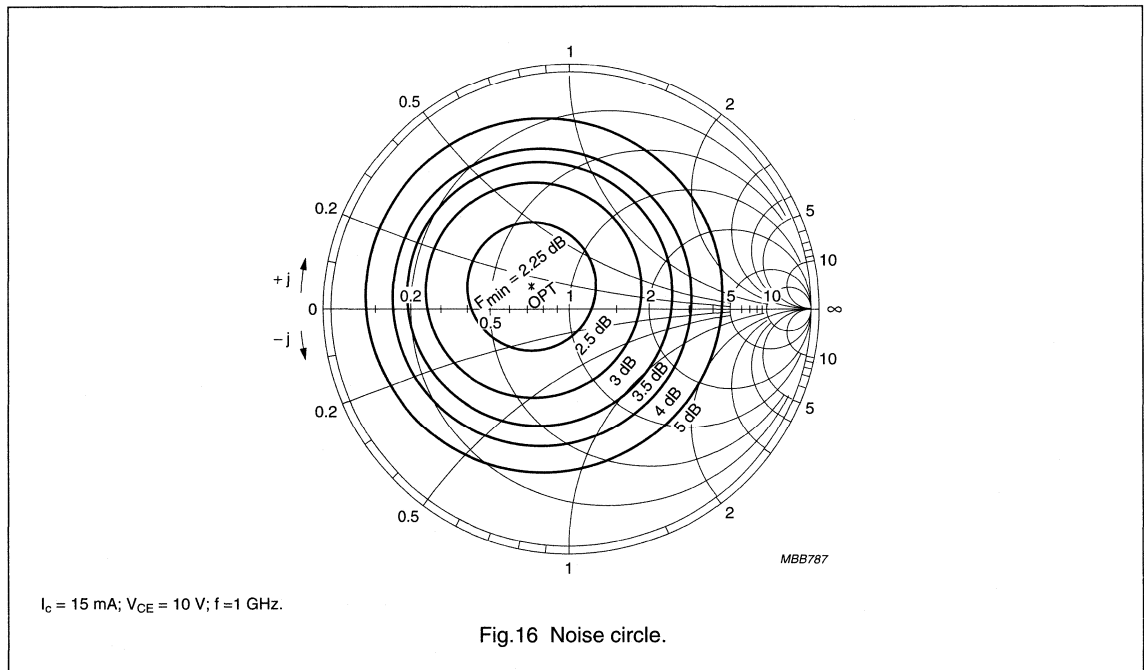
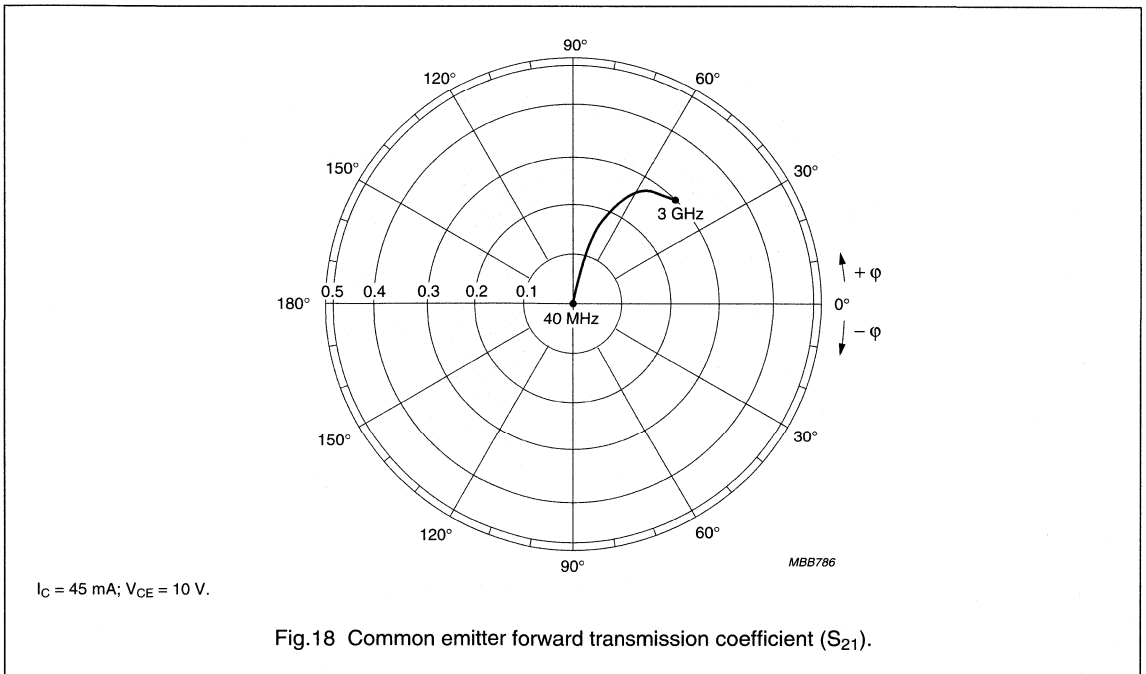
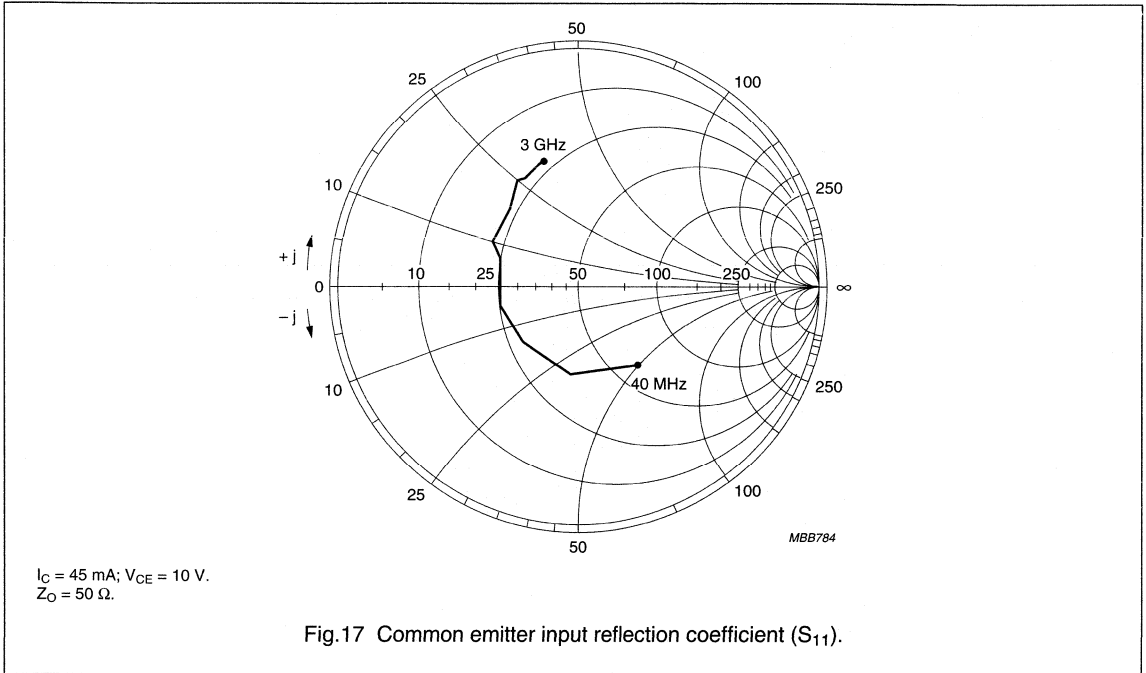


Fig.16 Noise circle.

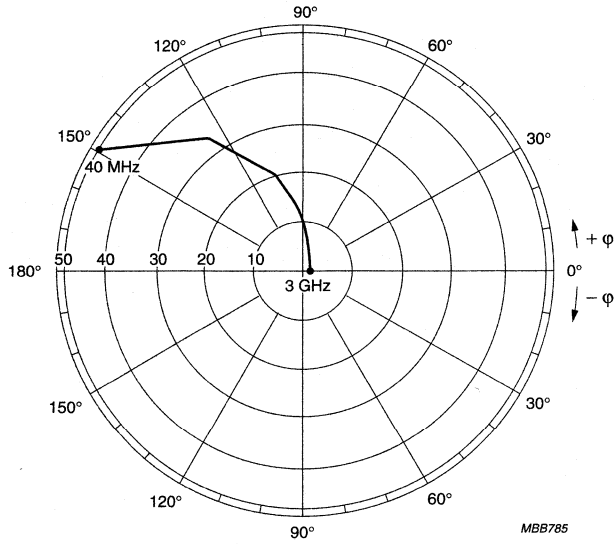
NPN 6 GHz wideband transistor

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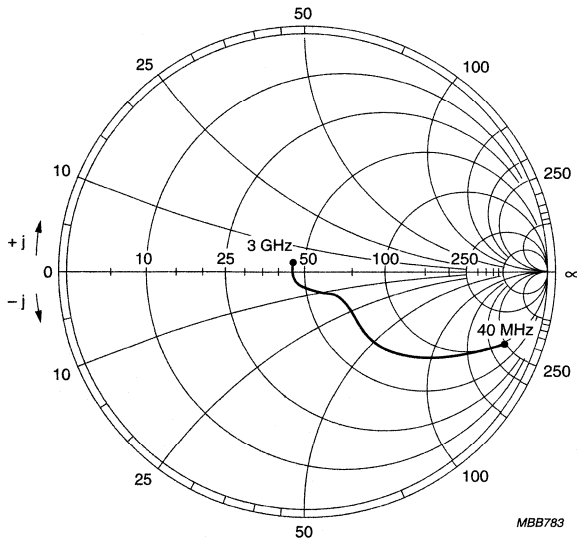
NPN 6 GHz wideband transistor

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$I_C = 45 \text{ mA}$; $V_{CE} = 10 \text{ V}$.

Fig.19 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 45 \text{ mA}$; $V_{CE} = 10 \text{ V}$.
 $Z_0 = 50 \Omega$.

Fig.20 Common emitter output reflection coefficient (S_{22}).

NPN 5 GHz wideband transistor

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DESCRIPTION

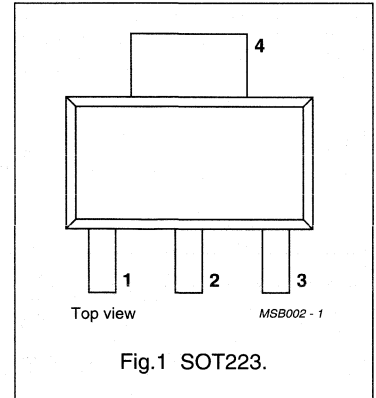
NPN planar epitaxial transistor mounted in a plastic SOT223 envelope.

It features excellent output voltage capabilities, and is primarily intended for use in MATV applications.

PNP complement is the BFG31.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | — | — | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | — | — | 15 | V |
| I_C | DC collector current | | — | — | 100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 125\text{ }^\circ\text{C}$ (note 1) | — | — | 1 | W |
| h_{FE} | DC current gain | $I_C = 70\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$ | 25 | 80 | — | |
| f_T | transition frequency | $I_C = 70\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | — | 5.5 | — | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 70\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | — | 16 | — | dB |
| | | $I_C = 70\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | — | 12 | — | dB |
| V_o | output voltage | $I_C = 70\text{ mA}$; $V_{CE} = 10\text{ V}$; $d_{im} = -60\text{ dB}$; $R_L = 75\text{ }\Omega$; $f_{(p+q-r)} = 793.25\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | — | 700 | — | mV |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | — | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | — | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | — | 3 | V |
| I_C | DC collector current | | — | 100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 125\text{ }^\circ\text{C}$ (note 1) | — | 1 | W |
| T_{stg} | storage temperature | | -65 | 150 | $^\circ\text{C}$ |
| T_j | junction temperature | | — | 175 | $^\circ\text{C}$ |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 5 GHz wideband transistor

BFG97

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 125\text{ °C}$ (note 1) | 50 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 10\text{ V}$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 70\text{ mA}; V_{CE} = 10\text{ V}$ | 25 | 80 | – | |
| f_T | transition frequency | $I_C = 70\text{ mA}; V_{CE} = 10\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 5.5 | – | GHz |
| C_c | collector capacitance | $I_E = I_e = 0; V_{CB} = 10\text{ V}; f = 1\text{ MHz}$ | – | 1.5 | – | pF |
| C_e | emitter capacitance | $I_C = I_c = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 6.5 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = 10\text{ V}; f = 1\text{ MHz}$ | – | 1 | – | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 70\text{ mA}; V_{CE} = 10\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 16 | – | dB |
| | | $I_C = 70\text{ mA}; V_{CE} = 10\text{ V};$ $f = 800\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 12 | – | dB |
| V_o | output voltage | note 2 | – | 750 | – | mV |
| | | note 3 | – | 700 | – | mV |
| d_2 | second order intermodulation distortion | note 4 | – | –56 | – | dB |
| | | note 5 | – | –53 | – | dB |

Notes

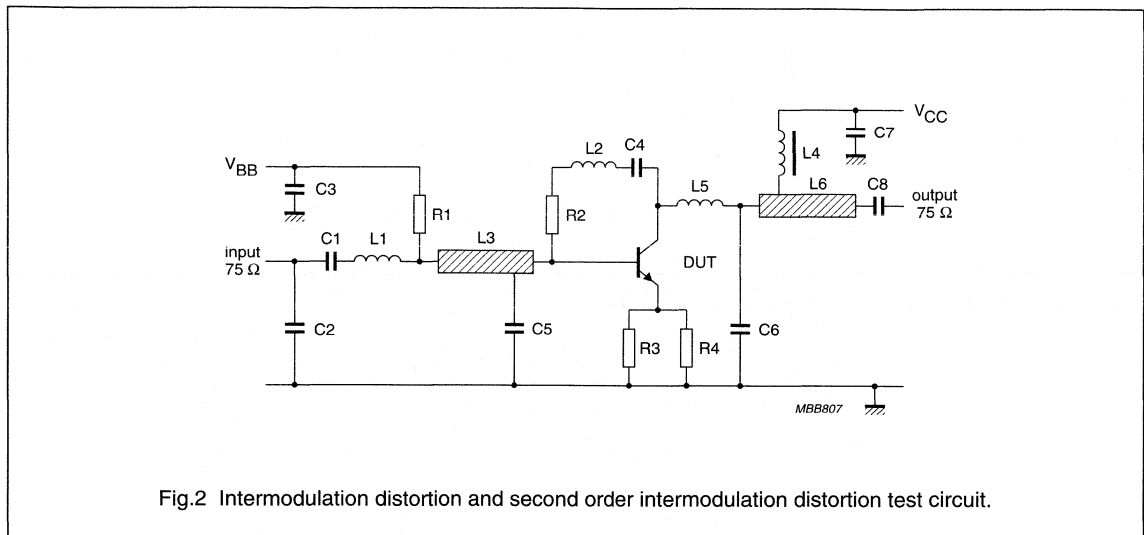
- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 70\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ °C}$
 $V_p = V_o$ at $d_{im} = -60\text{ dB}$;
 $V_q = V_o - 6\text{ dB}; f_p = 445.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_q = 453.25\text{ MHz}; f_r = 455.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 443.25\text{ MHz}$.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 70\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ °C}$
 $V_p = V_o$ at $d_{im} = -60\text{ dB}$;
 $V_q = V_o - 6\text{ dB}; f_p = 795.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_q = 803.25\text{ MHz}; f_r = 805.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 793.25\text{ MHz}$.
- $I_C = 70\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ °C};$
 $V_p = V_q = V_o = 50\text{ dBmV}; f_{(p+q)} = 450\text{ MHz}; f_p = 50\text{ MHz}; f_q = 400\text{ MHz}.$
- $I_C = 70\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ °C};$
 $V_p = V_q = V_o = 50\text{ dBmV}; f_{(p+q)} = 810\text{ MHz}; f_p = 250\text{ MHz}; f_q = 560\text{ MHz}.$

NPN 5 GHz wideband transistor

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List of components (see test circuit)

| DESIGNATION | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE NO. |
|-----------------|-----------------------------------|--------|---------------------------------------|----------------|
| C2, C3, C7, C8 | multilayer ceramic capacitor | 10 nF | | 2222 590 08627 |
| C1, C4, C6 | multilayer ceramic capacitor | 1.2 pF | | 2222 851 12128 |
| C5 (note 1) | miniature ceramic plate capacitor | 10 nF | | 2222 629 08103 |
| L1 (note 1) | 0.5 turns 0.4 mm copper wire | | int. dia. 3 mm | |
| L2 | microstripline | 75 Ω | length 14 mm; width 2.5 mm | |
| L3 | microstripline | 75 Ω | length 8 mm; width 2.5 mm | |
| L4, L5 (note 1) | 1.5 turns 0.4 mm copper wire | | int. dia. 3 mm; winding pitch 1 mm | |
| L6 | microstripline | 75 Ω | length 19 mm; width 2.5 mm | |
| L7 | Ferroxcube choke | 5 μH | | 3122 108 20153 |
| R1 | metal film resistor | 10 kΩ | | 2322 180 73103 |
| R2 (note 1) | metal film resistor | 220 Ω | | 2322 180 73221 |
| R3, R4 | metal film resistor | 30 Ω | | 2322 180 73309 |

Notes

The circuit has been built on a double copper-clad printed circuit board with PTFE dielectric ($\epsilon_r = 2.2$); thickness $\frac{1}{16}$ inch; thickness of copper sheet $2 \times 35 \mu\text{m}$.

1. Components C5, L1, L4, L5, and R2 are mounted on the underside of the PCB.

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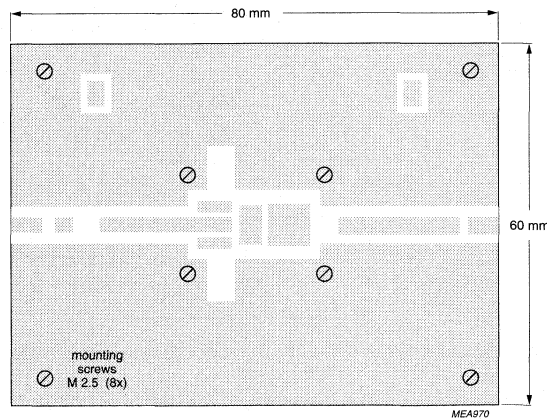
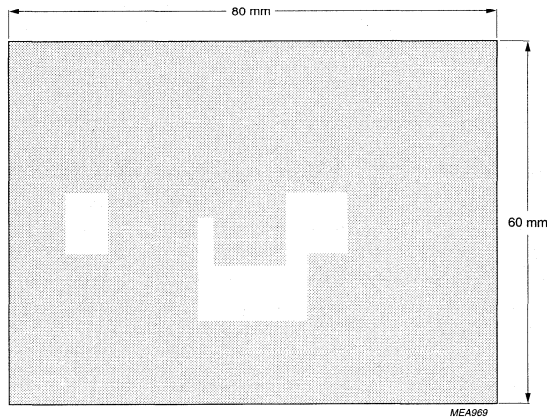
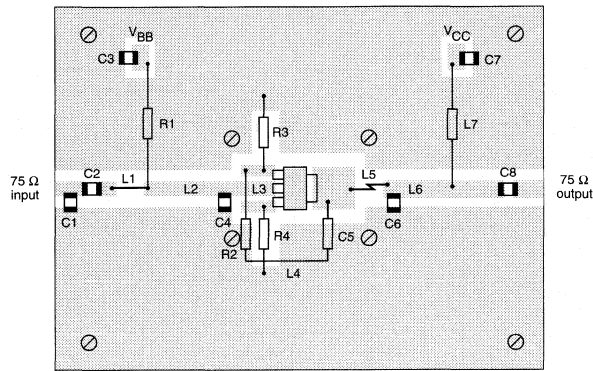
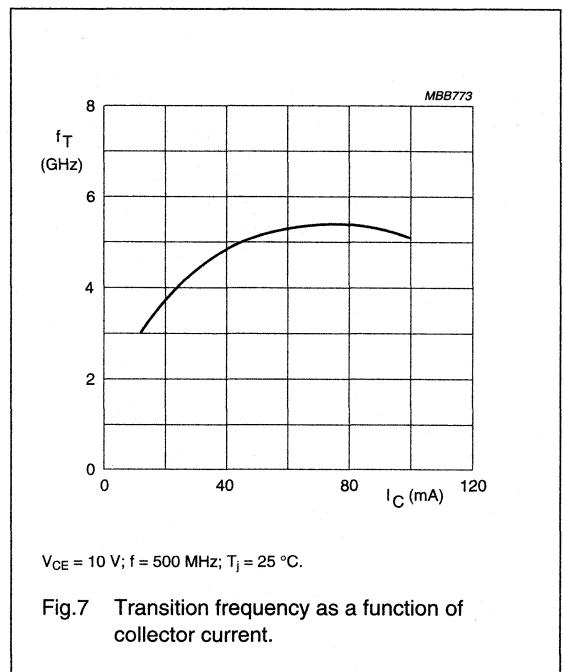
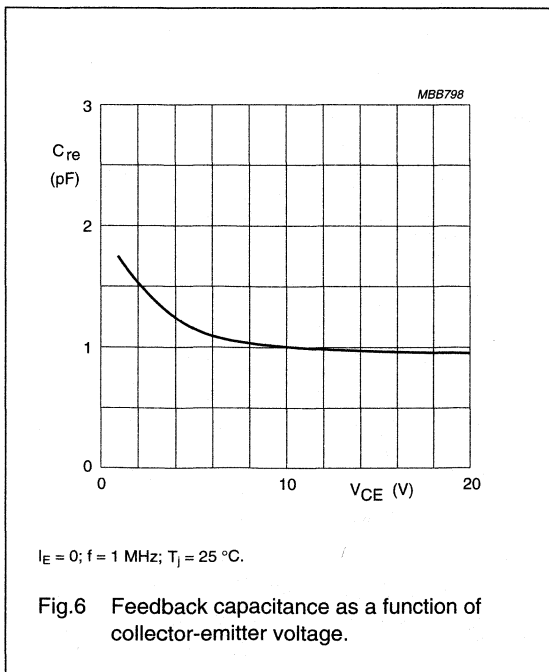
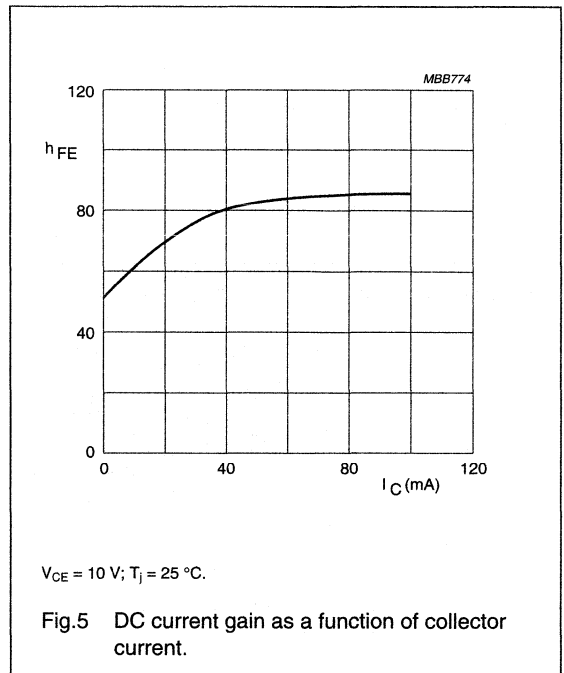
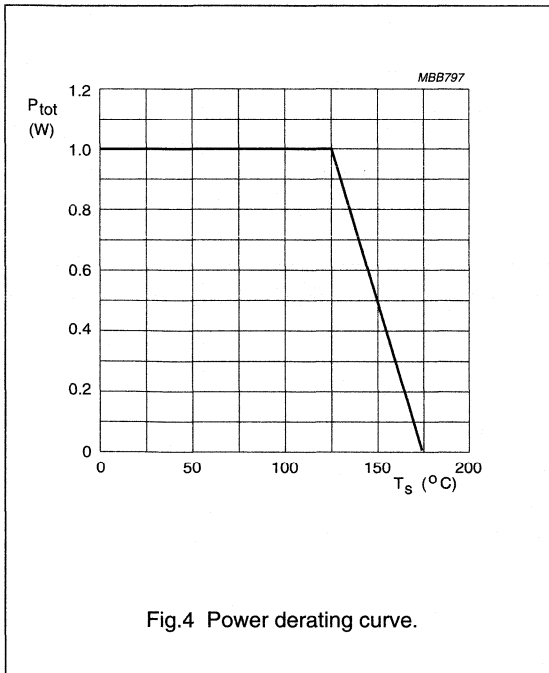


Fig.3 Intermodulation distortion and second order intermodulation distortion printed circuit board.

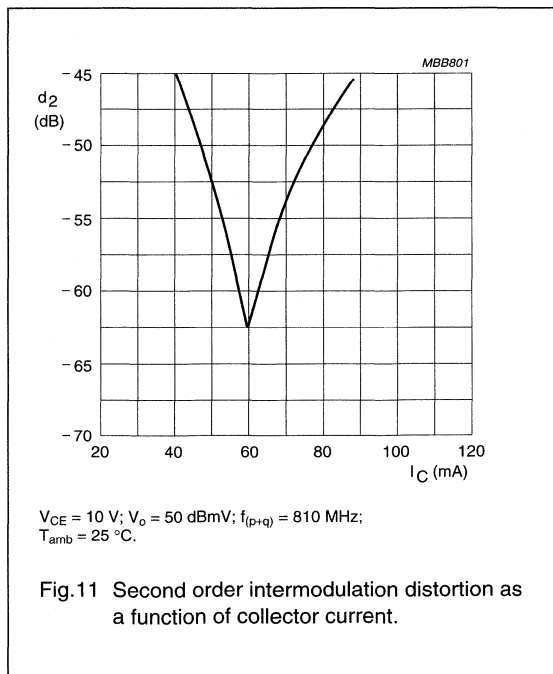
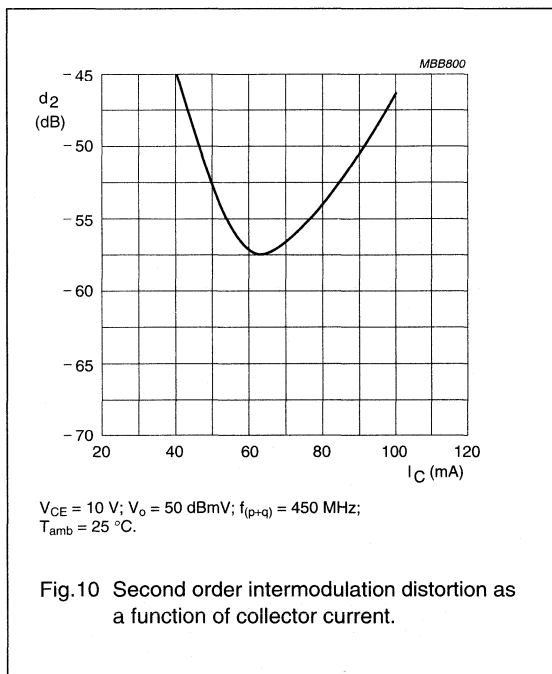
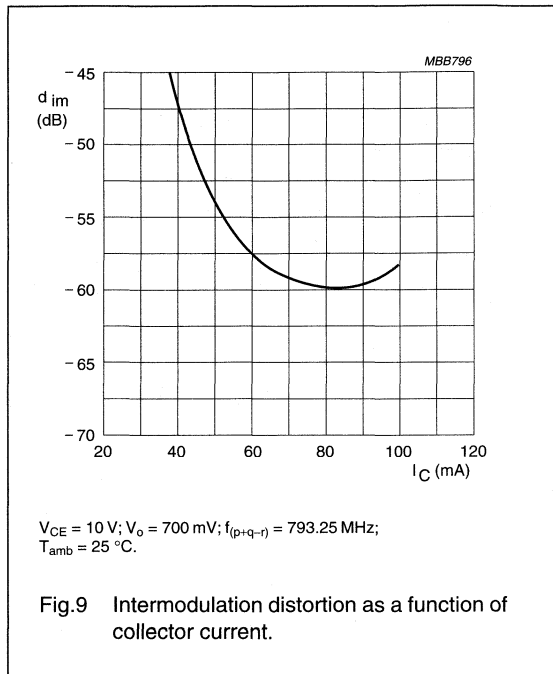
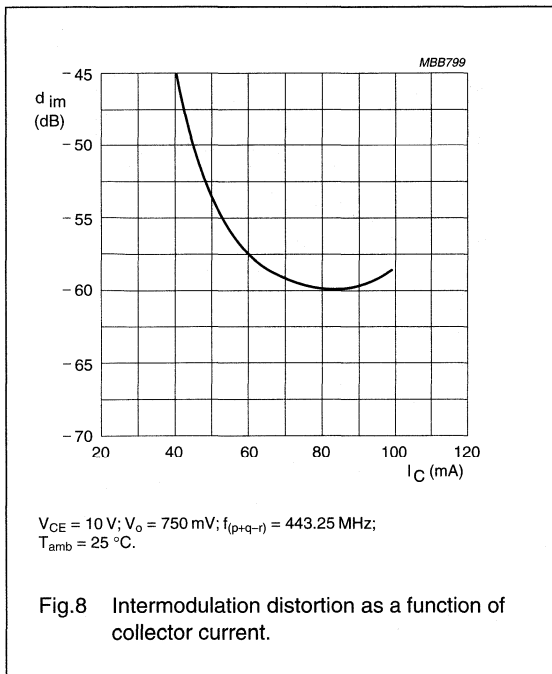
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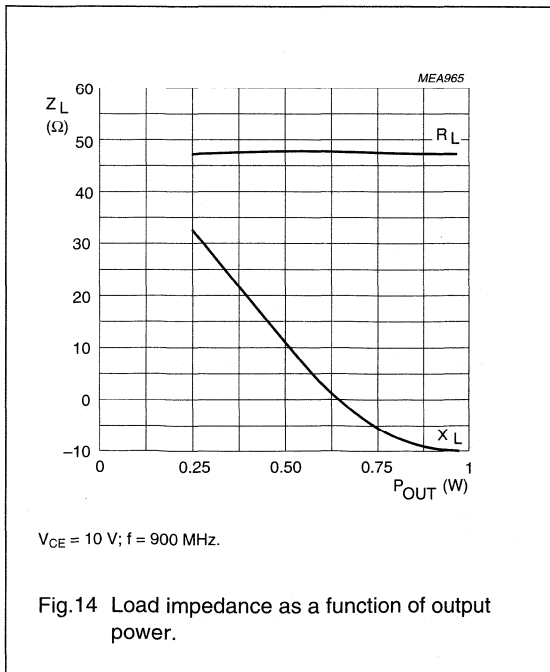
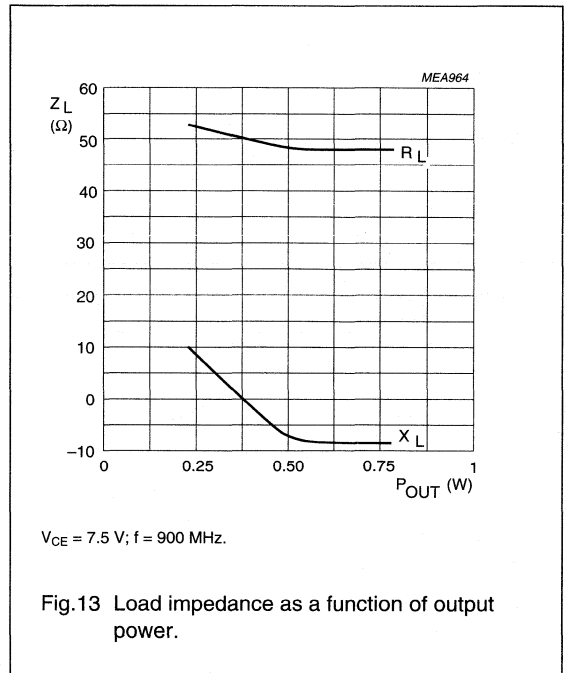
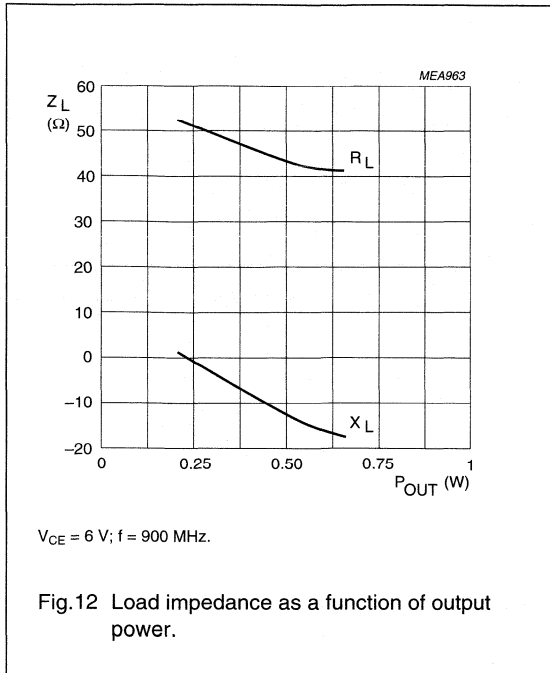
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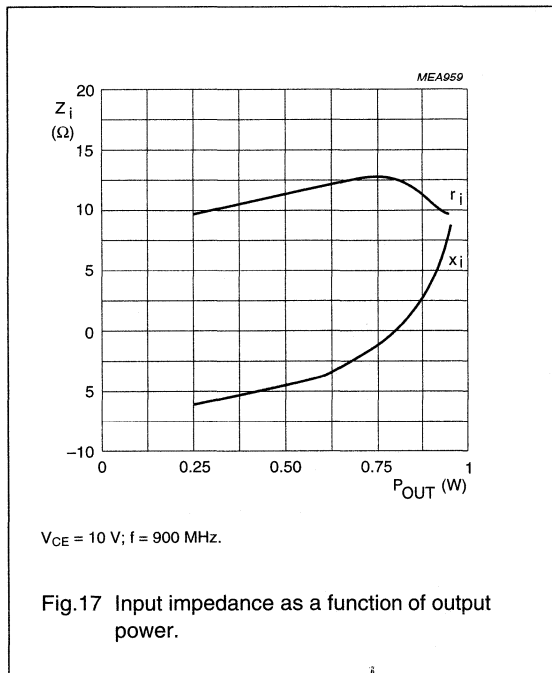
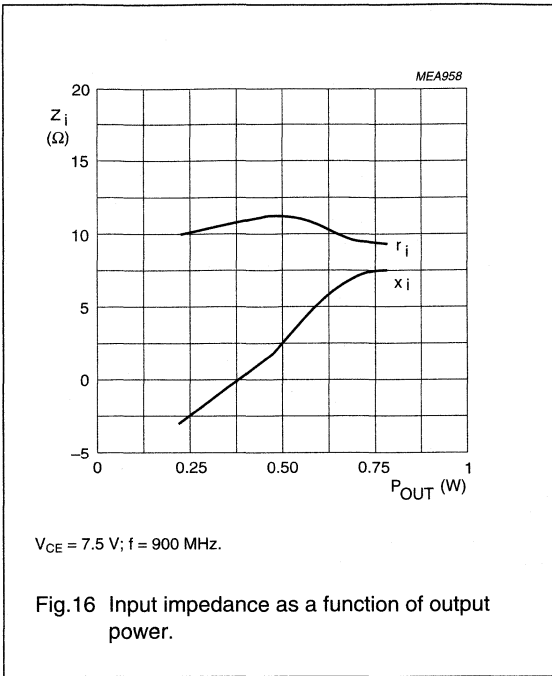
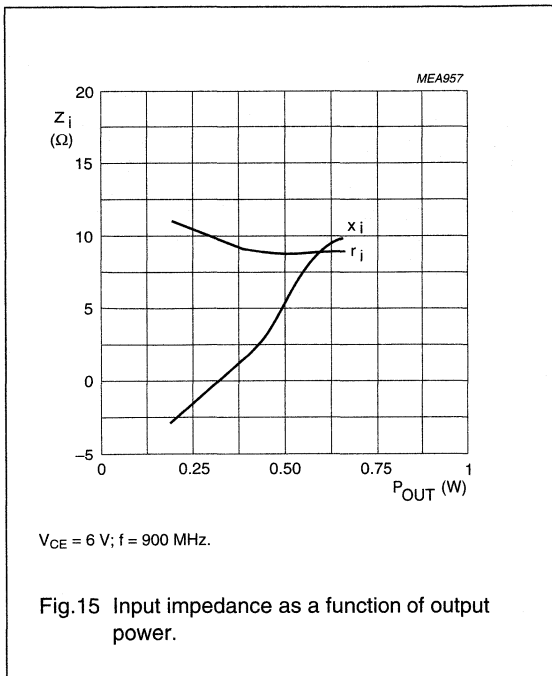
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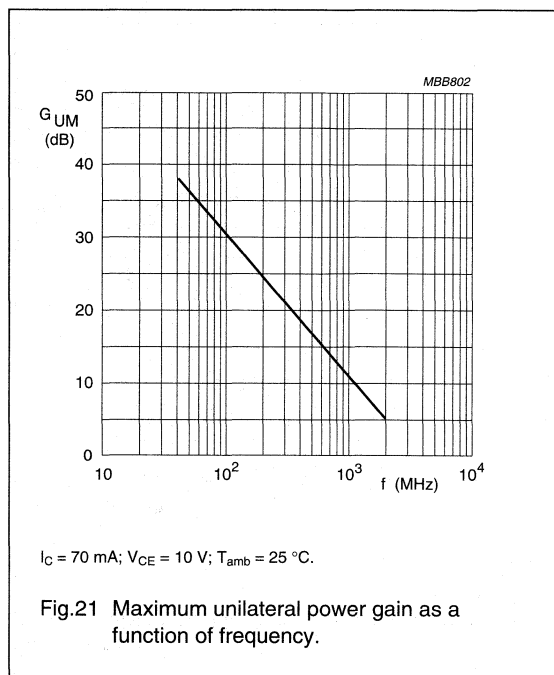
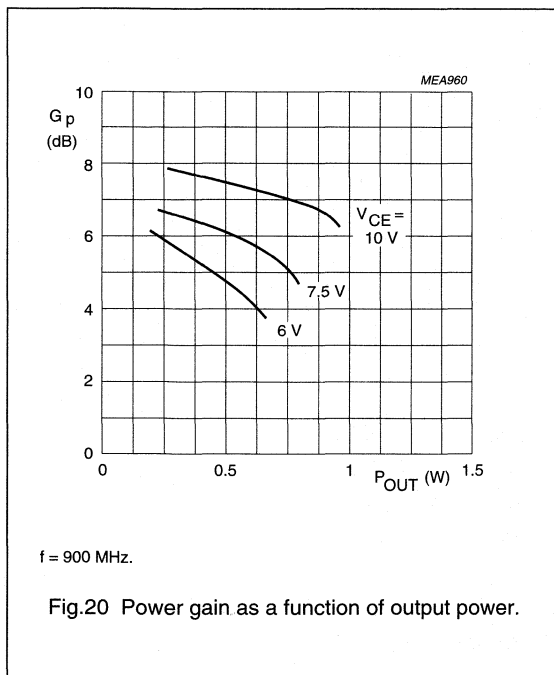
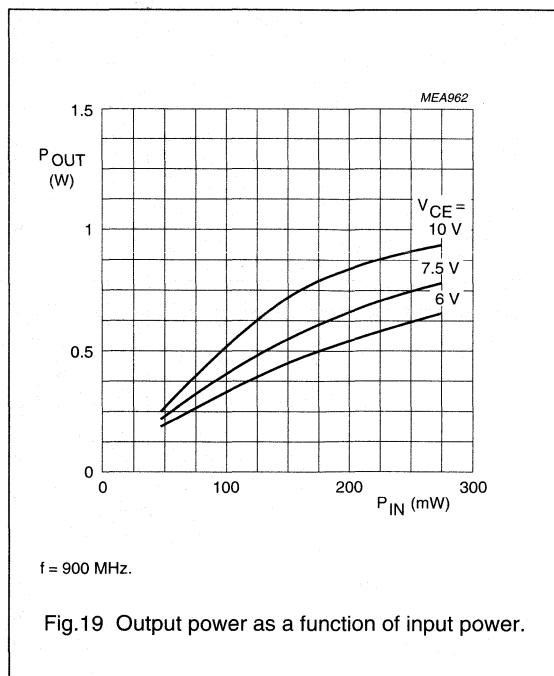
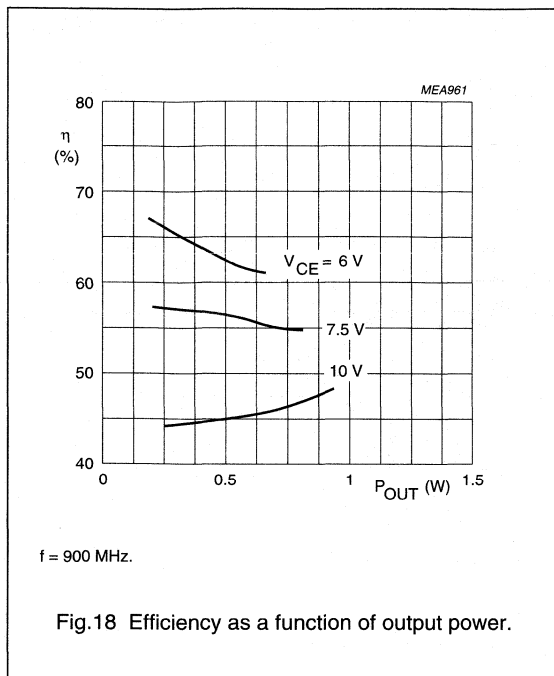
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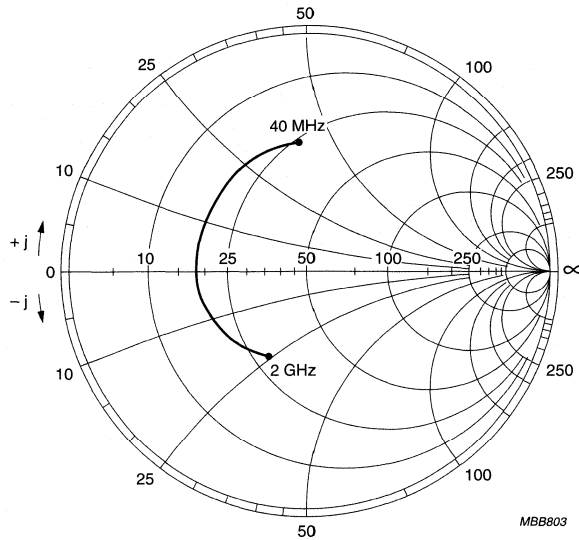
NPN 5 GHz wideband transistor

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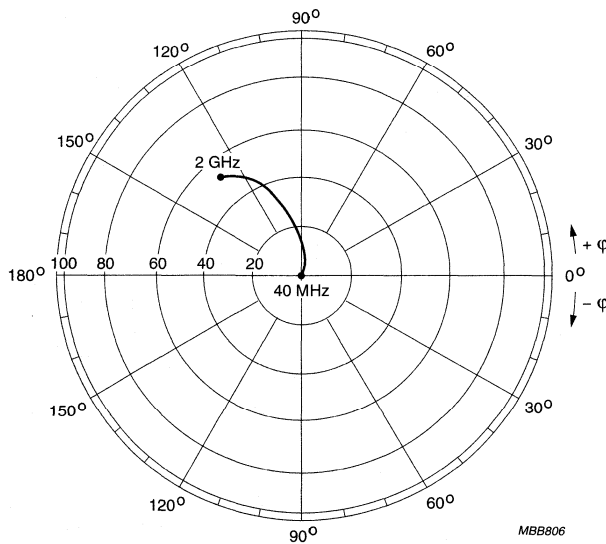
NPN 5 GHz wideband transistor

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$I_C = 70 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_o = 50 \text{ } \Omega$.

Fig.22 Common emitter input reflection coefficient (S_{11}).

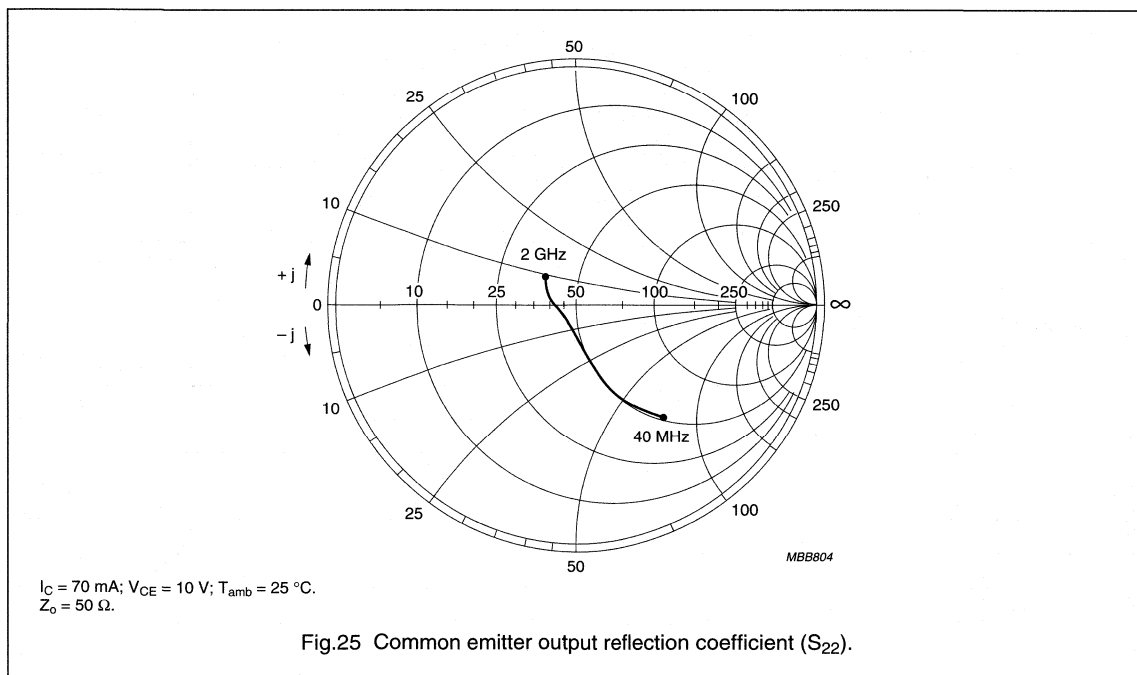
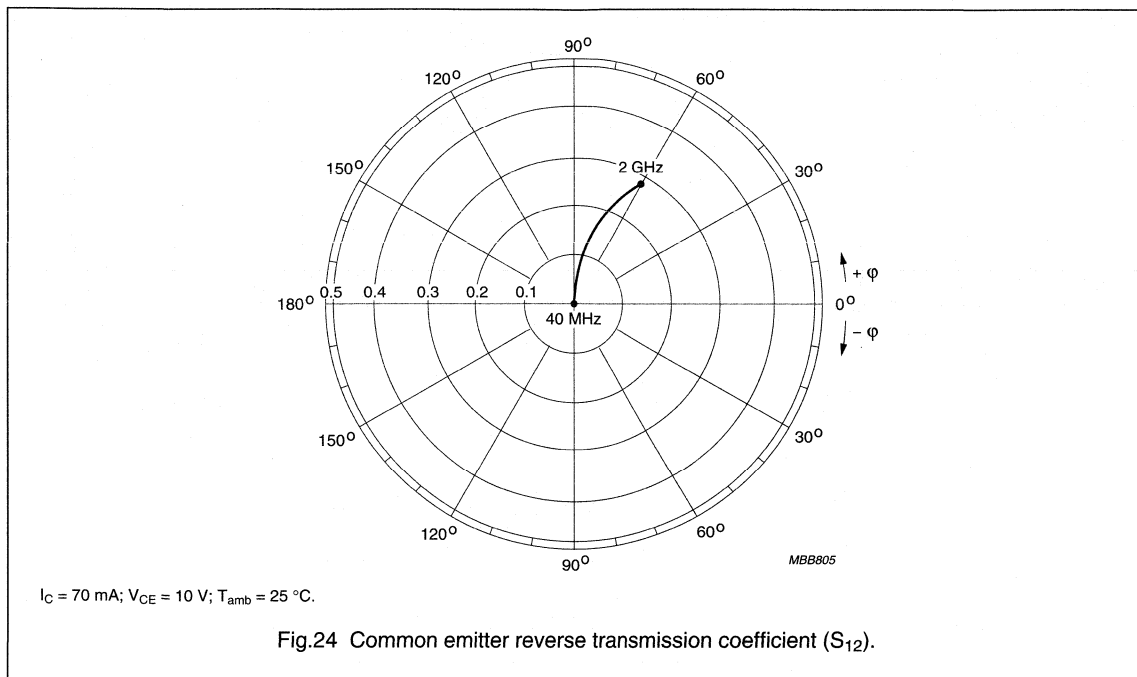


$I_C = 70 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.23 Common emitter forward transmission coefficient (S_{21}).

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NPN 7GHz wideband transistor

BFG135

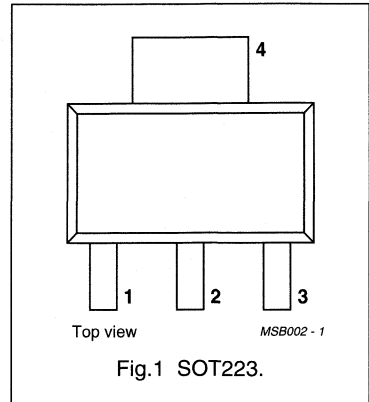
DESCRIPTION

NPN silicon planar epitaxial transistor in a plastic SOT223 envelope, intended for wideband amplifier applications. The small emitter structures, with integrated emitter-ballasting resistors, ensure high output voltage capabilities at a low distortion level.

The distribution of the active areas across the surface of the device gives an excellent temperature profile.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | DC collector current | | – | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 145\text{ °C}$ (note 1) | – | – | 1 | W |
| h_{FE} | DC current gain | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $T_j = 25\text{ °C}$ | 80 | 130 | – | |
| f_T | transition frequency | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 7 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 16 | – | dB |
| | | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 12 | – | dB |
| V_o | output voltage | $d_{im} = -60\text{ dB}$; $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\text{ }\Omega$; $T_{amb} = 25\text{ °C}$; $f_{(p+q-r)} = 793.25\text{ MHz}$ | – | 850 | – | mV |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 145\text{ °C}$ (note 1) | – | 1 | W |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 7GHz wideband transistor

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THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 145\text{ °C}$ (note 1) | 30 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|---------------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 1 | μA |
| h_{FE} | DC current gain | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$ | 80 | 130 | – | |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 2 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 7 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 1.2 | – | pF |
| f_T | transition frequency | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 7 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 16 | – | dB |
| | | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 12 | – | dB |
| V_o | output voltage | note 1 | – | 900 | – | mV |
| | | note 2 | – | 850 | – | mV |
| d_2 | second order intermodulation distortion | $I_C = 90\text{ mA}$; $V_{CE} = 10\text{ V}$; $V_O = 50\text{ dBmV}$; $T_{amb} = 25\text{ °C}$; $f_{(p+q)} = 450\text{ MHz}$; $f_p = 50\text{ MHz}$; $f_q = 400\text{ MHz}$ | – | –58 | – | dB |
| | | $I_C = 90\text{ mA}$; $V_{CE} = 10\text{ V}$; $V_O = 50\text{ dBmV}$; $T_{amb} = 25\text{ °C}$; $f_{(p+q)} = 810\text{ MHz}$; $f_p = 250\text{ MHz}$; $f_q = 560\text{ MHz}$ | – | –53 | – | dB |

Notes

- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$;
 $V_p = V_o$ at $d_{im} = -60\text{ dB}$; $f_p = 445.25\text{ MHz}$;
 $V_q = V_o - 6\text{ dB}$; $f_q = 453.25\text{ MHz}$;
 $V_r = V_o - 6\text{ dB}$; $f_r = 455.25\text{ MHz}$;
measured at $f_{(p+q-r)} = 443.25\text{ MHz}$.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$;
 $V_p = V_o$ at $d_{im} = -60\text{ dB}$; $f_p = 795.25\text{ MHz}$;
 $V_q = V_o - 6\text{ dB}$; $f_q = 803.25\text{ MHz}$;
 $V_r = V_o - 6\text{ dB}$; $f_r = 805.25\text{ MHz}$;
measured at $f_{(p+q-r)} = 793.25\text{ MHz}$.

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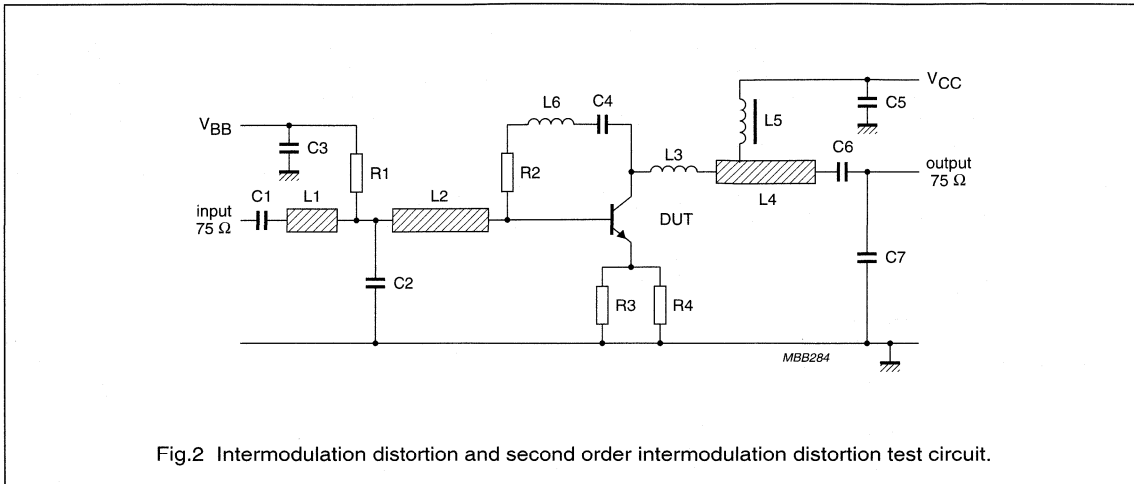


Fig.2 Intermodulation distortion and second order intermodulation distortion test circuit.

List of components (see test circuit)

| DESIGNATION | DESCRIPTION | VALUE | UNIT | DIMENSIONS | CATALOGUE NO. |
|----------------|-----------------------------------|--------------|------------|---------------------------------------|----------------|
| C1, C3, C5, C6 | multilayer ceramic capacitor | 10 | nF | | 2222 590 08627 |
| C2, C7 | multilayer ceramic capacitor | 1 | pF | | 2222 851 12108 |
| C4 (note 1) | miniature ceramic plate capacitor | 10 | nF | | 2222 629 08103 |
| L1 | microstripline | 75 | Ω | length 7 mm; width 2.5 mm | |
| L2 | microstripline | 75 | Ω | length 22mm; width 2.5 mm | |
| L3 (note 1) | 1.5 turns 0.4 mm copper wire | | | int. dia. 3 mm; winding pitch 1 mm | |
| L4 | microstripline | 75 | Ω | length 19 mm; width 2.5 mm | |
| L5 | Ferroxcube choke | 5 | μ H | | 3122 108 20153 |
| L6 (note 1) | 0.4 mm copper wire | \approx 25 | nH | length 30 mm | |
| R1 | metal film resistor | 10 | k Ω | | 2322 180 73103 |
| R2 (note 1) | metal film resistor | 200 | Ω | | 2322 180 73201 |
| R3, R4 | metal film resistor | 27 | Ω | | 2322 180 73279 |

Note

- Components C4, L3, L6 and R2 are mounted on the underside of the PCB.
The circuit is constructed on a double copper-clad printed circuit board with PTFE dielectric ($\epsilon_r = 2.2$); thickness $\frac{1}{16}$ inch; thickness of copper sheet $\frac{1}{32}$ inch.

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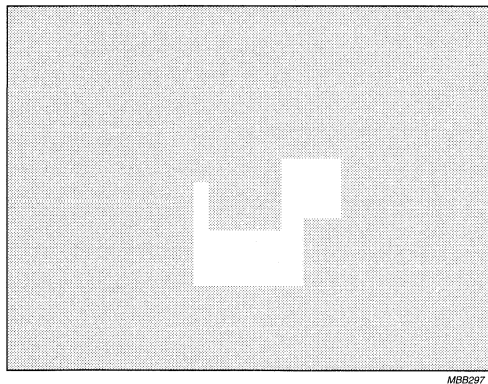
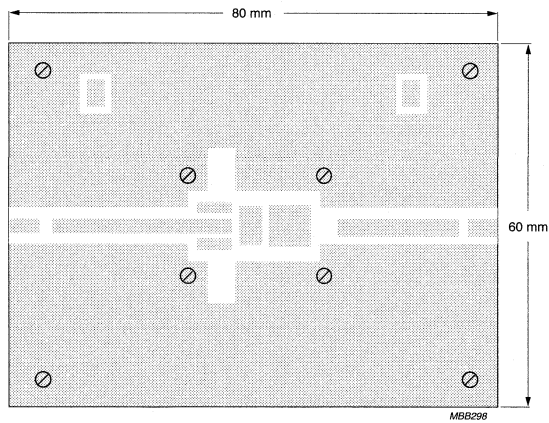
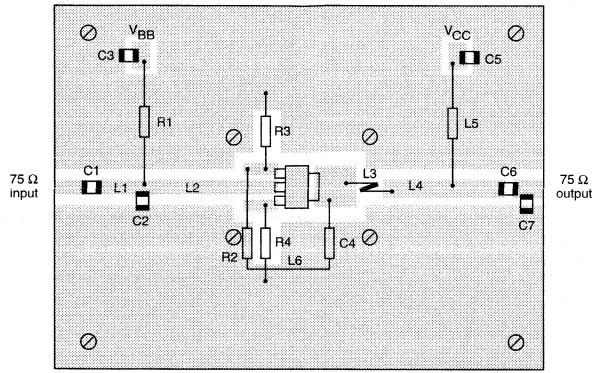
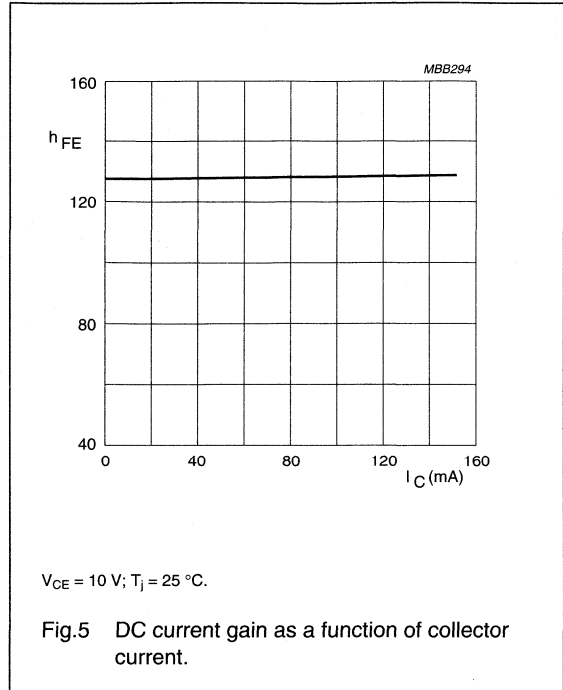
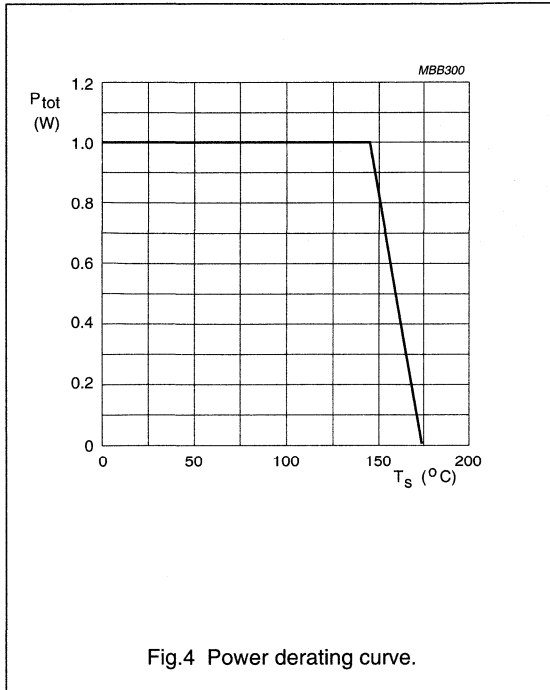


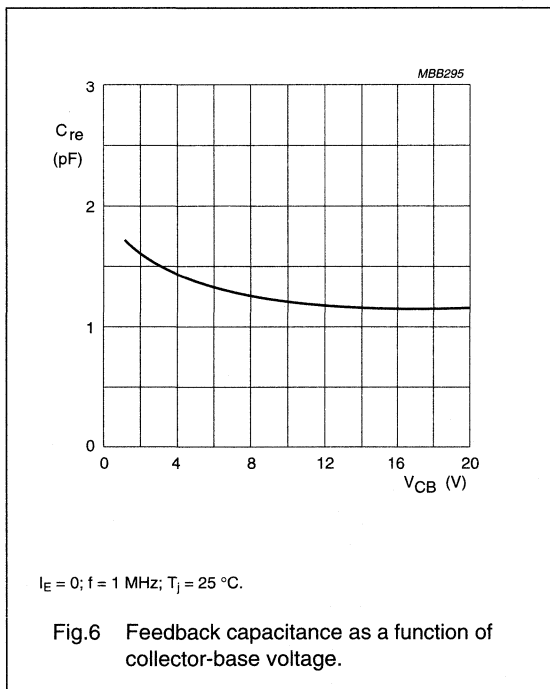
Fig.3 Intermodulation distortion test printed-circuit board.

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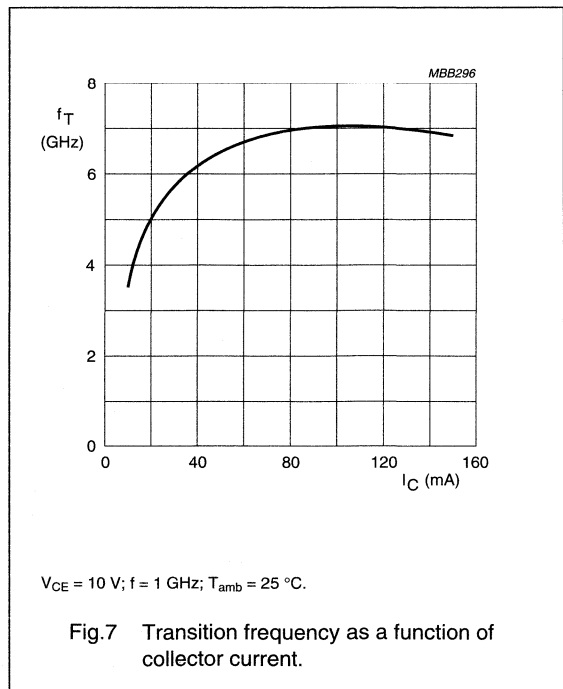
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$V_{CE} = 10\text{ V}; T_j = 25\text{ }^\circ\text{C}.$



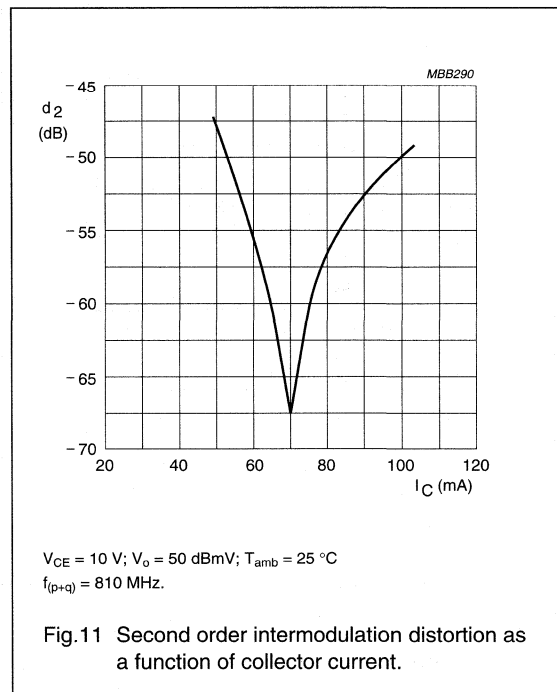
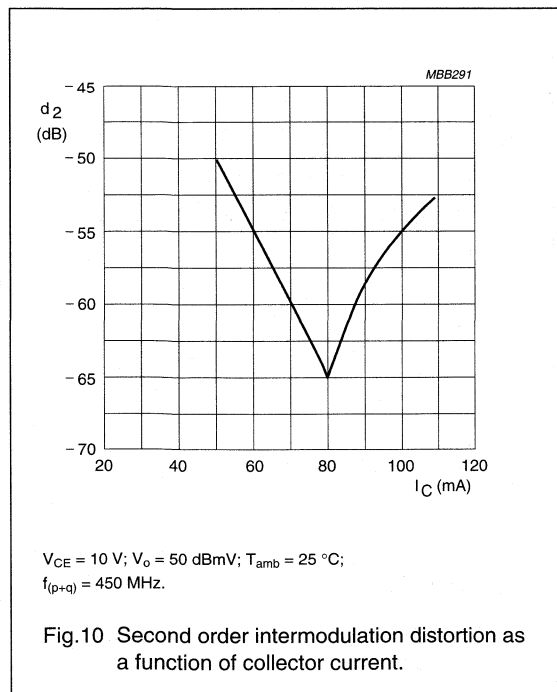
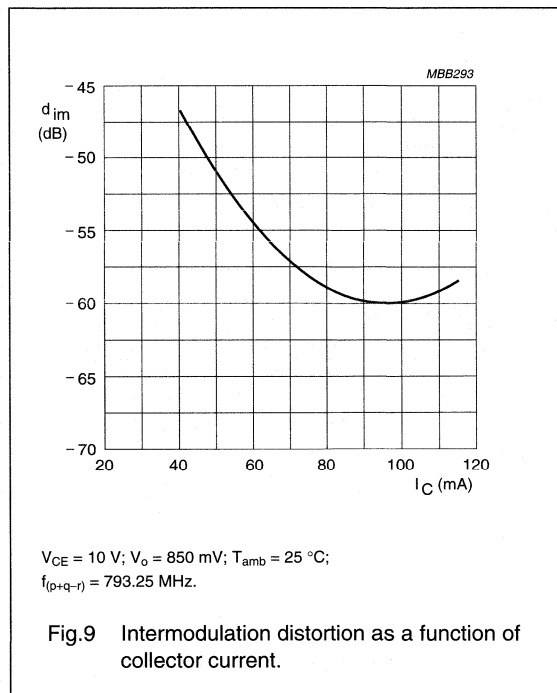
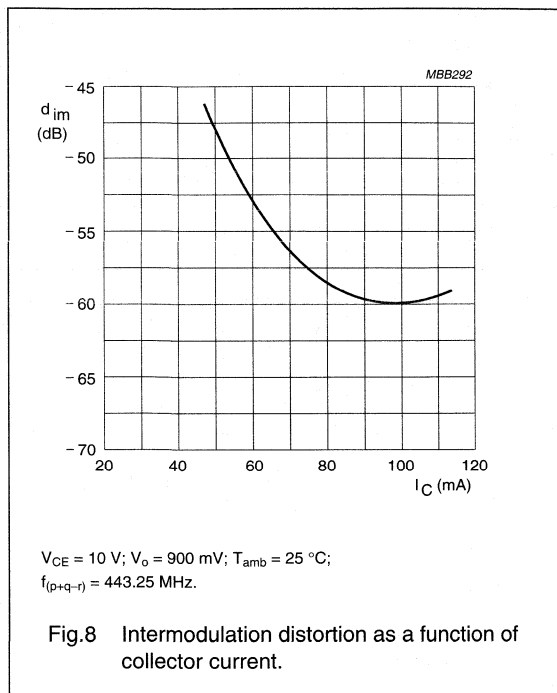
$I_E = 0; f = 1\text{ MHz}; T_j = 25\text{ }^\circ\text{C}.$



$V_{CE} = 10\text{ V}; f = 1\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}.$

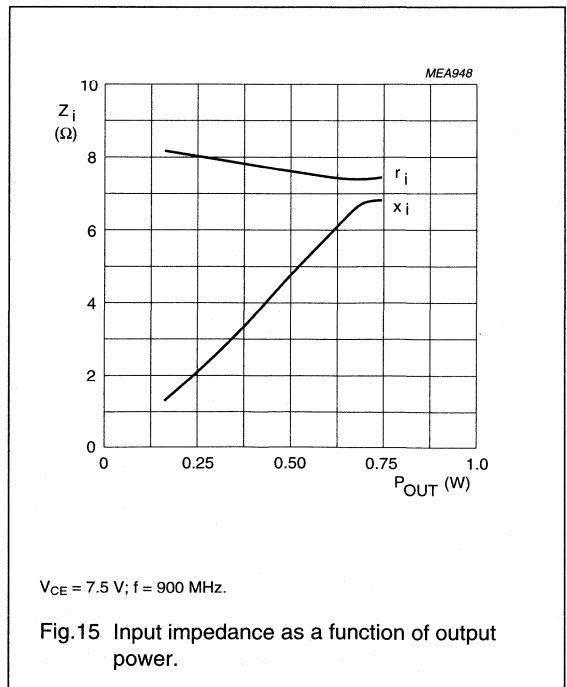
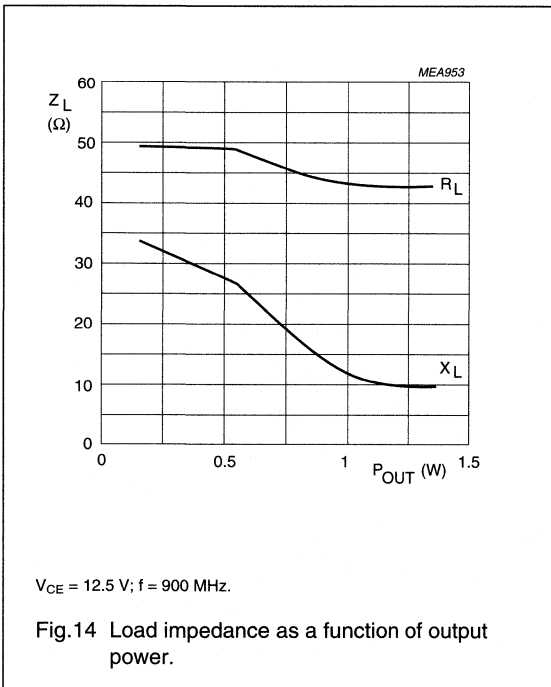
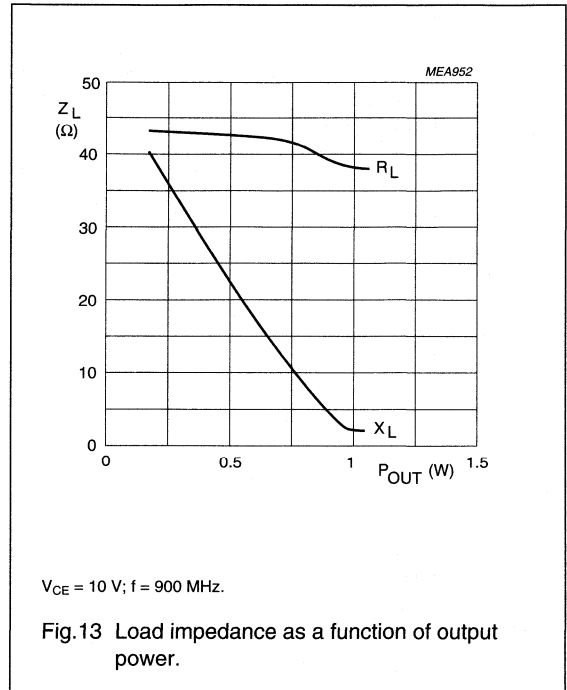
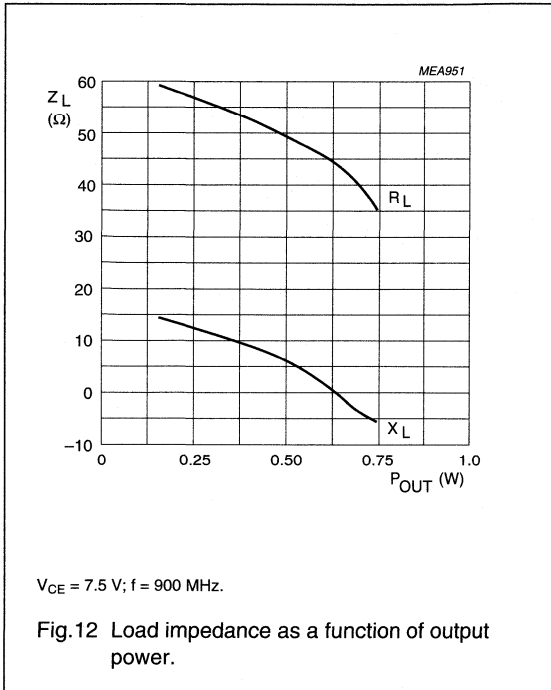
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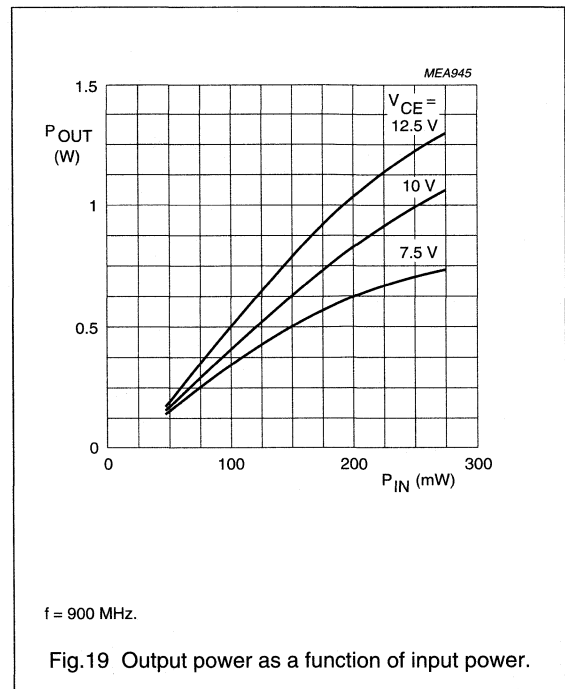
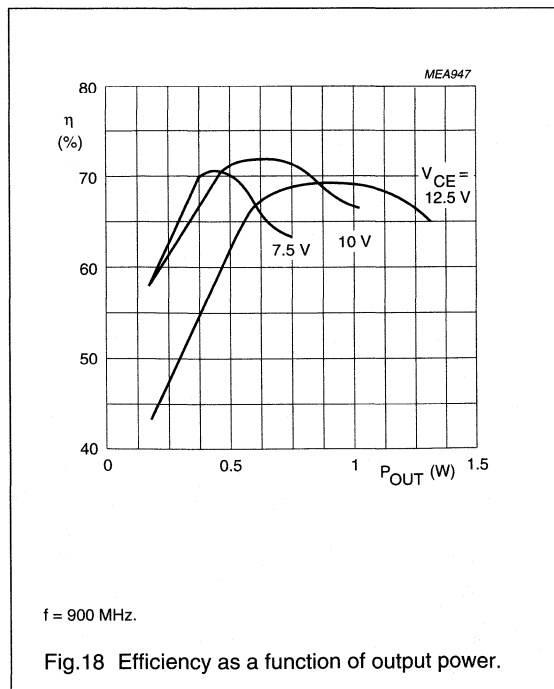
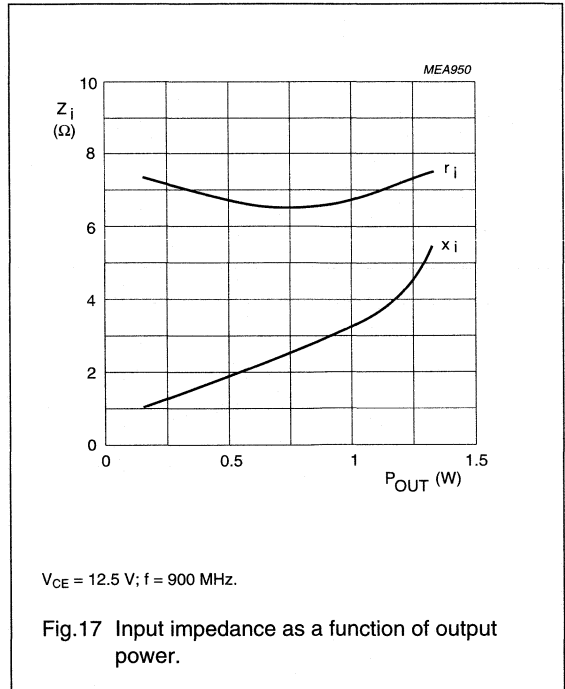
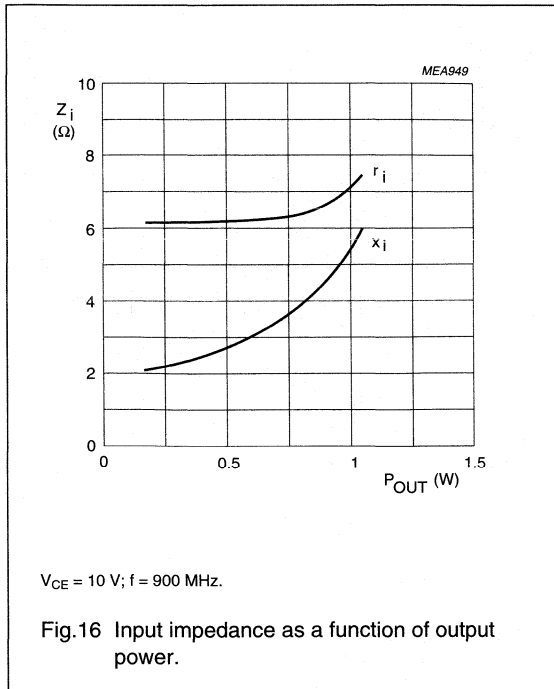
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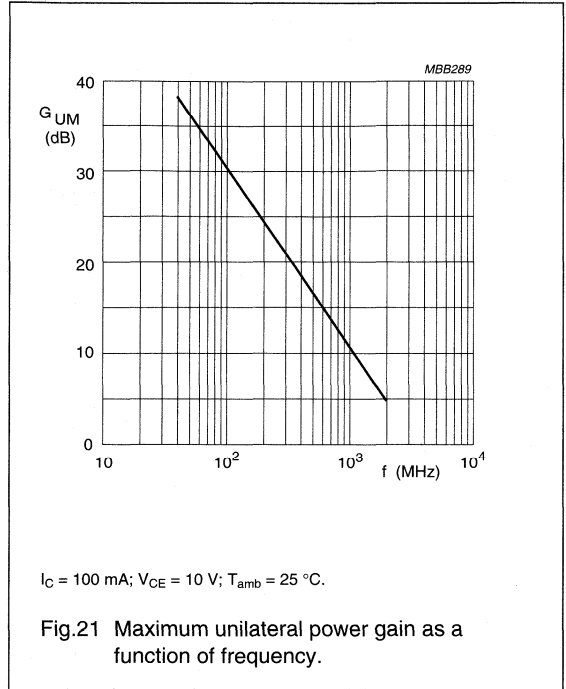
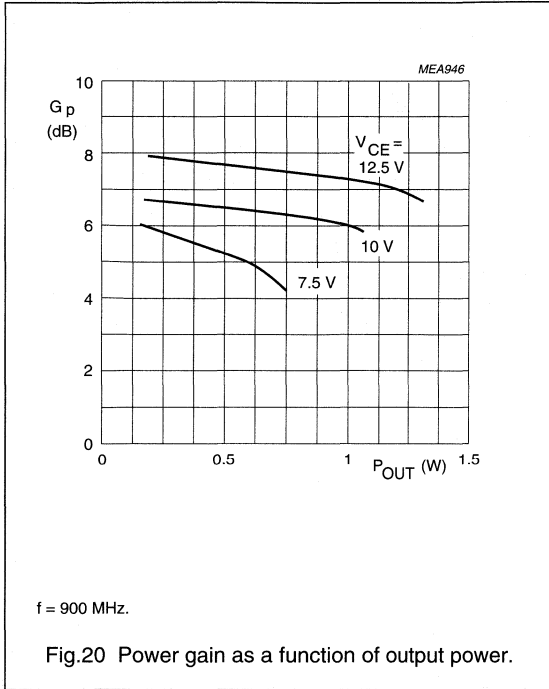
NPN 7GHz wideband transistor

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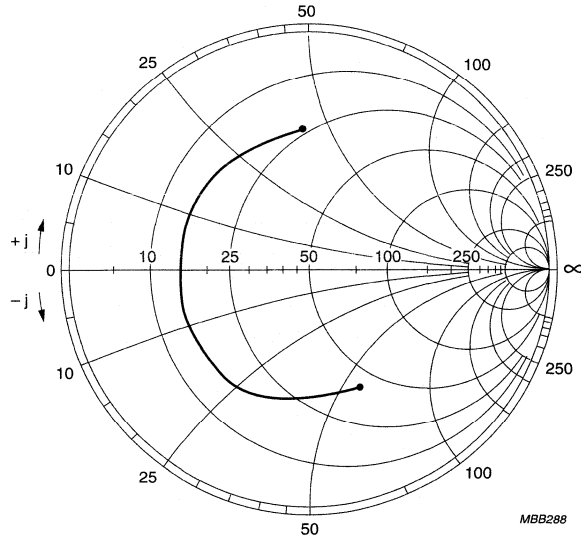
NPN 7GHz wideband transistor

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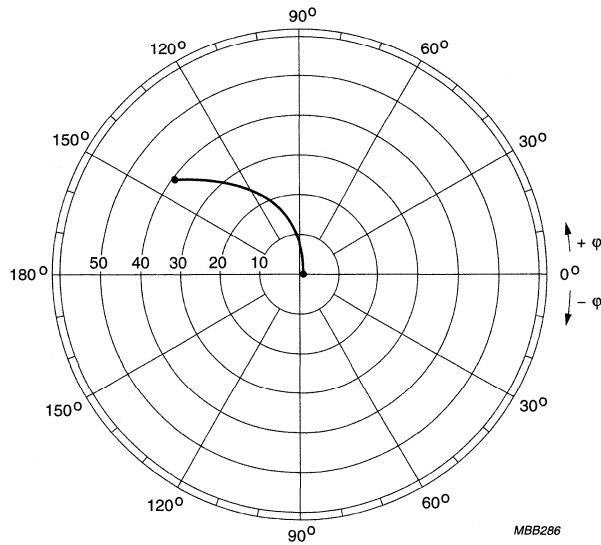
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$I_C = 100 \text{ mA}; V_{CE} = 10 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}; Z_o = 50 \text{ } \Omega.$

Fig.22 Common emitter input reflection coefficient (S_{11}).

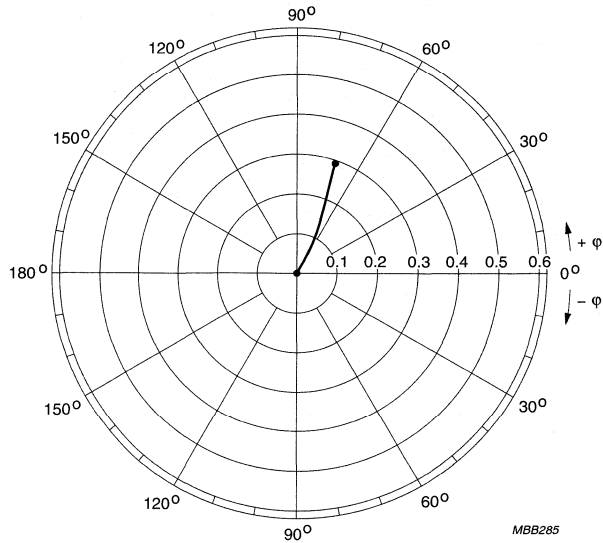


$I_C = 100 \text{ mA}; V_{CE} = 10 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}.$

Fig.23 Common emitter forward transmission coefficient (S_{21}).

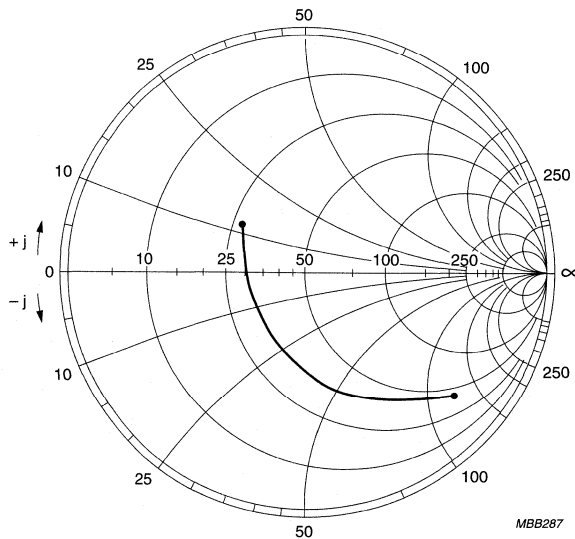
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$I_C = 100 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.24 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 100 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$; $Z_0 = 50 \text{ } \Omega$.

Fig.25 Common emitter output reflection coefficient (S_{22}).

NPN 7 GHz wideband transistor

BFG197; BFG197/X;
BFG197/XR

FEATURES

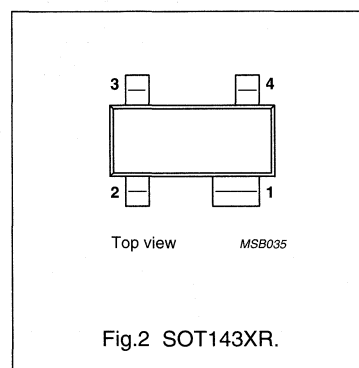
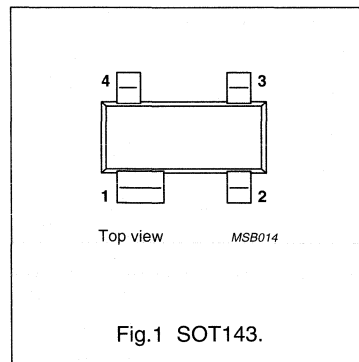
- High power gain
- Low noise figure
- Gold metallization ensures excellent reliability.

DESCRIPTION

The BFG197 is a silicon NPN transistor in a 4-pin, dual-emitter plastic SOT143 envelope. It is primarily intended for wideband applications in the GHz range, such as satellite TV systems and repeater amplifiers in fibre-optic systems.

PINNING

| PIN | DESCRIPTION |
|-----------------------------|-------------|
| BFG197 (Fig.1) Code: V5 | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG197/X (Fig.1) Code: V13 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG197/XR (Fig.2) Code: V35 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 10 | V |
| I_C | collector current | DC value | – | – | 100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 75\text{ °C}$; note 1 | – | – | 350 | mW |
| C_{re} | feedback capacitance | $I_C = i_c = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.85 | – | pF |
| f_T | transition frequency | $I_C = 50\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 2\text{ GHz}$ | – | 7.5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 50\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 1\text{ GHz}$ | – | 16 | – | dB |
| | | $I_C = 50\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 2\text{ GHz}$ | – | 10 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 1\text{ GHz}$ | – | 1.7 | – | dB |

Note

1. T_s is the temperature at the soldering point of the collector tab.

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BFG197; BFG197/X;
BFG197/XR

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current | DC value, continuous | – | 100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 75\text{ °C}$; note 1 | – | 350 | mW |
| T_{stg} | storage temperature range | | –65 | +150 | °C |
| T_j | junction operating temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|--|-------|------|
| $R_{th\ j-s}$ | from junction to soldering point; note 1 | 290 | K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

 $T_j = 25\text{ °C}$ unless otherwise specified.

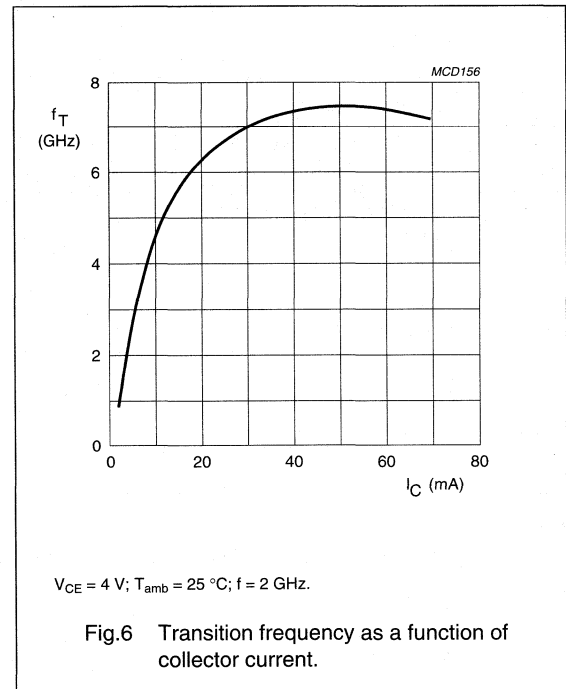
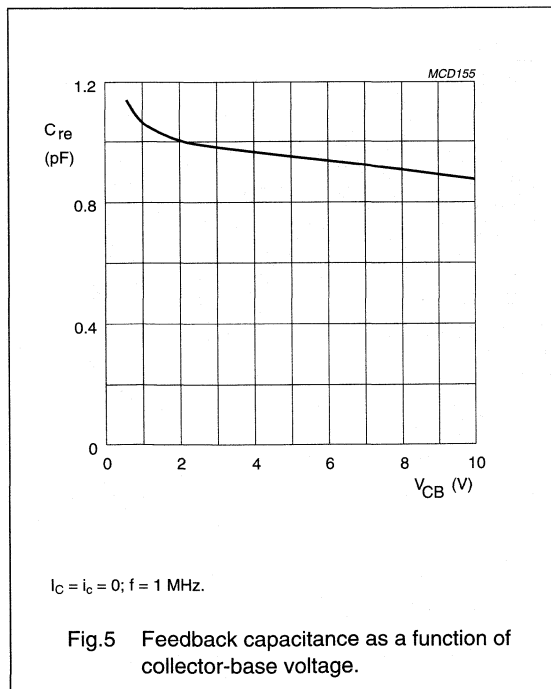
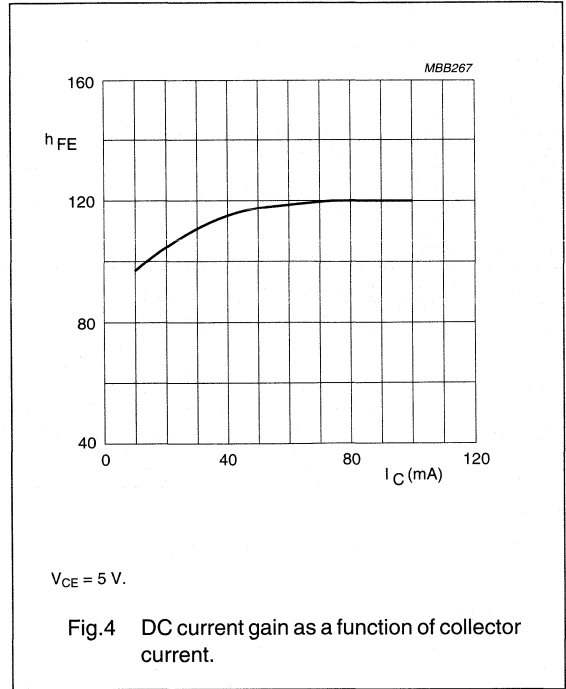
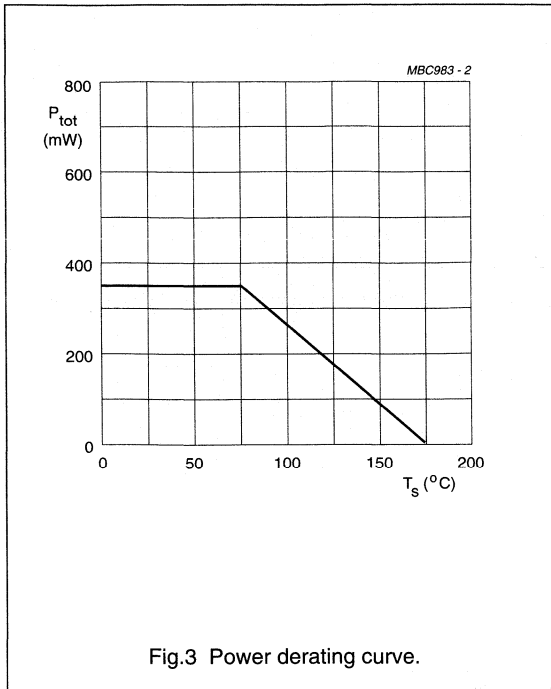
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|------|
| I_{CBO} | collector leakage current | $I_E = 0$; $V_{CB} = 5\text{ V}$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 50\text{ mA}$; $V_{CE} = 5\text{ V}$ | 40 | 110 | – | |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 1.5 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 3.3 | – | pF |
| C_{re} | feedback capacitance | $I_C = i_c = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.85 | – | pF |
| f_T | transition frequency | $I_C = 50\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 2\text{ GHz}$ | – | 7.5 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 50\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 1\text{ GHz}$ | – | 16 | – | dB |
| | | $I_C = 50\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 2\text{ GHz}$ | – | 10 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 1\text{ GHz}$ | – | 1.7 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 50\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 2\text{ GHz}$ | – | 2.3 | – | dB |
| d_2 | second order intermodulation distortion | $V_{CE} = 6\text{ V}$; $V_o = 50\text{ dBmV}$; | – | –51 | – | dB |

Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

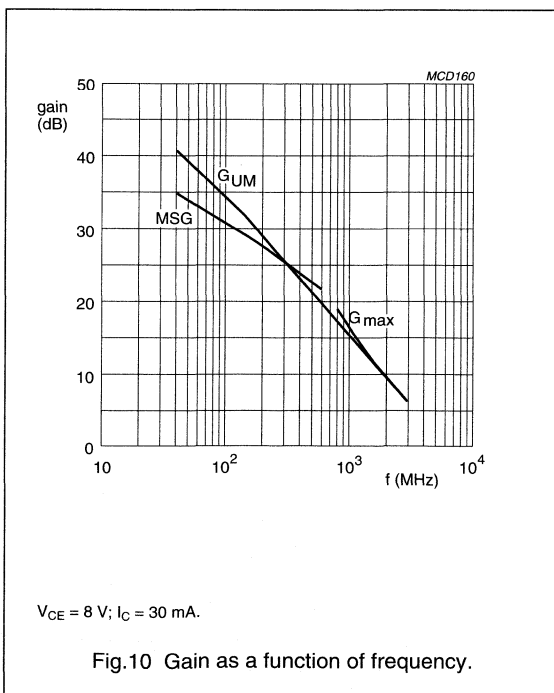
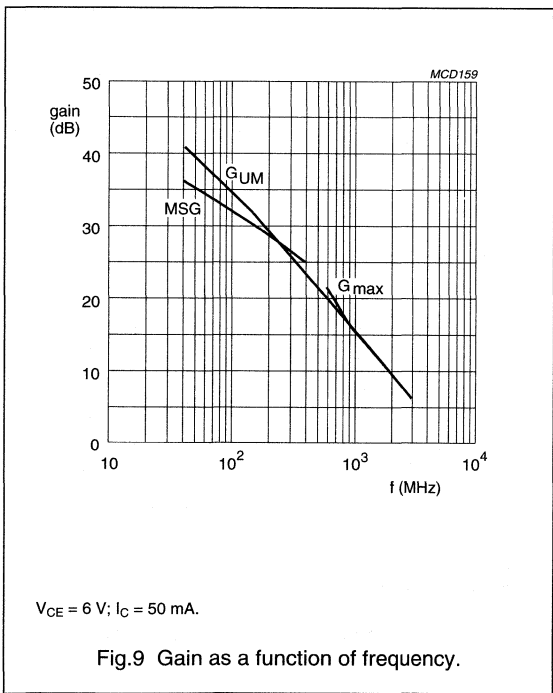
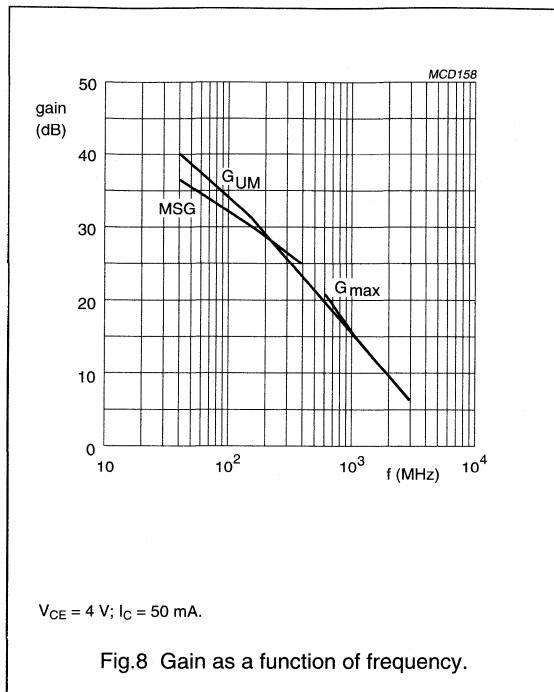
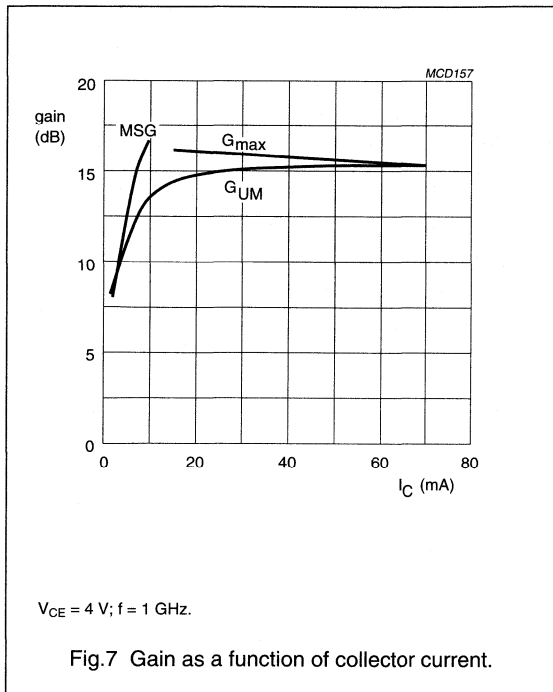
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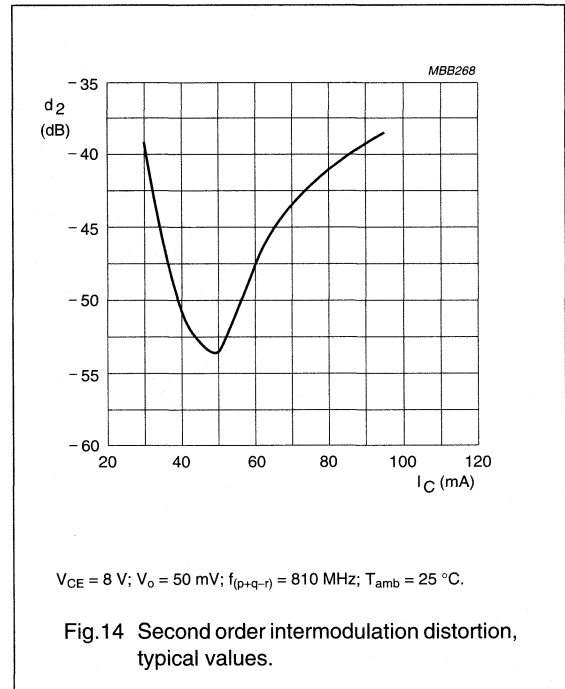
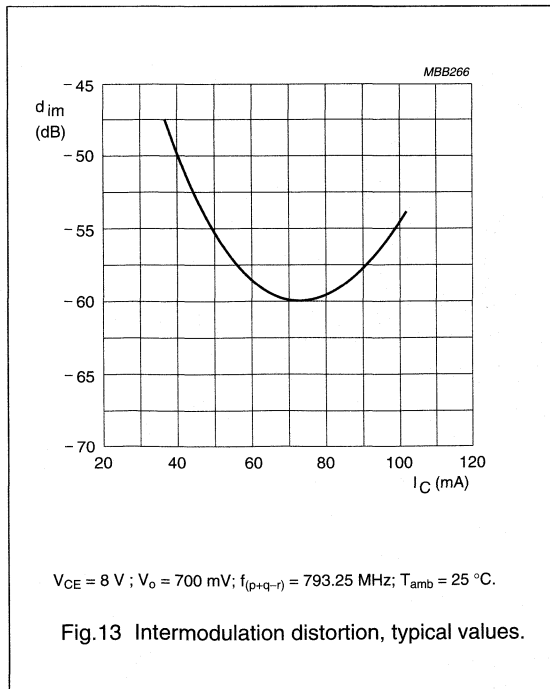
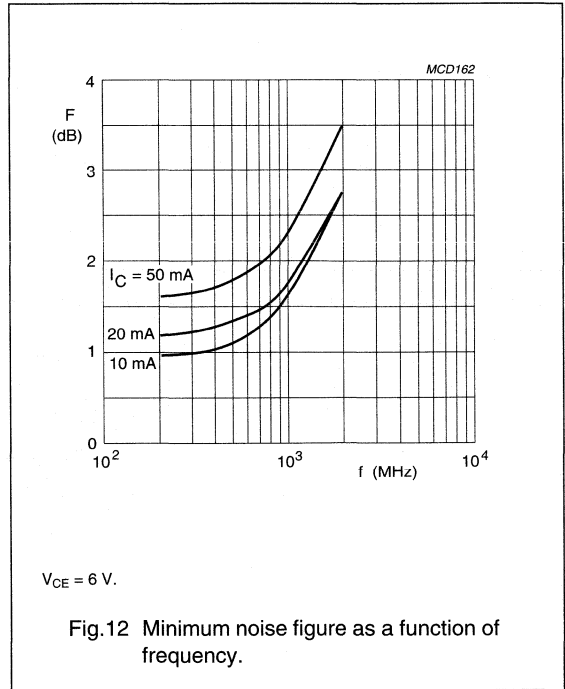
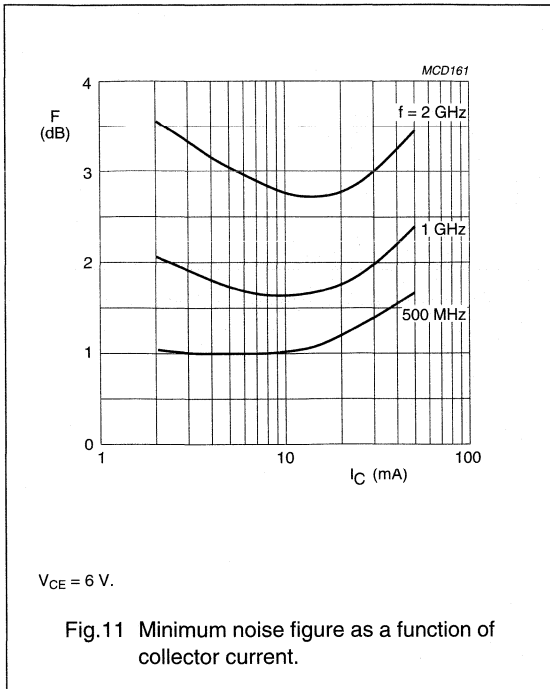
NPN 7 GHz wideband transistor

BFG197; BFG197/X;
BFG197/XR



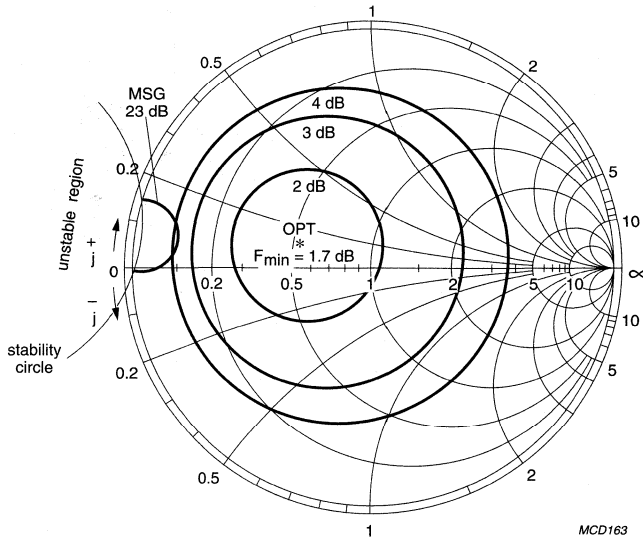
NPN 7 GHz wideband transistor

BFG197; BFG197/X;
BFG197/XR



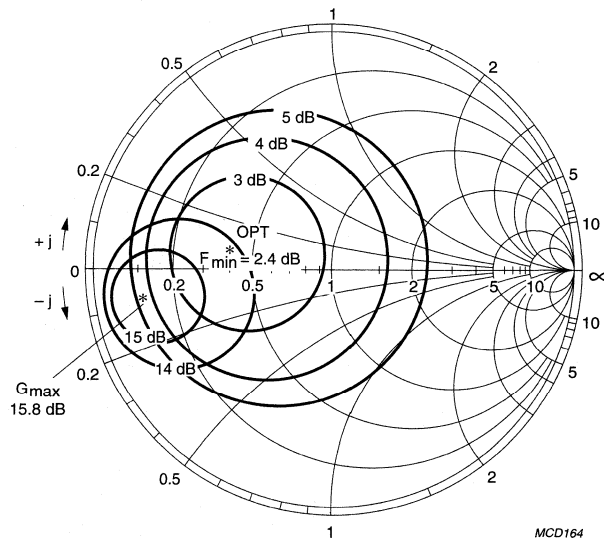
NPN 7 GHz wideband transistor

BFG197; BFG197/X;
BFG197/XR



$Z_0 = 50 \Omega$.
Maximum stable gain = 23 dB.

Fig.15 Noise circle figure.

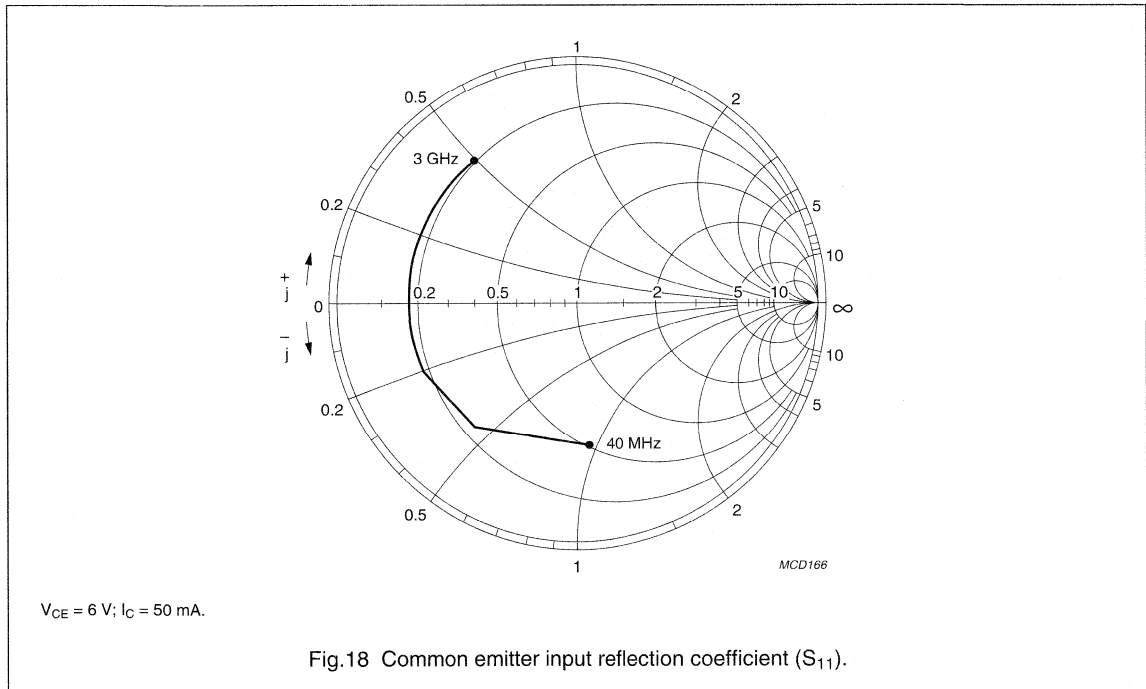
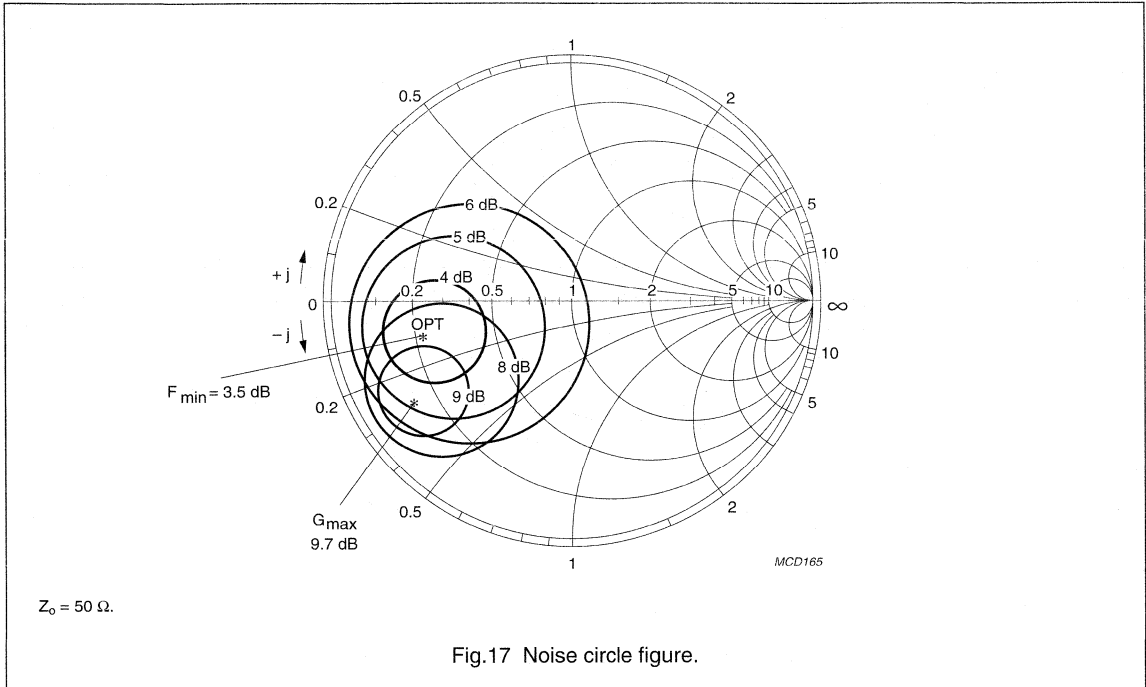


$Z_0 = 50 \Omega$.

Fig.16 Noise circle figure.

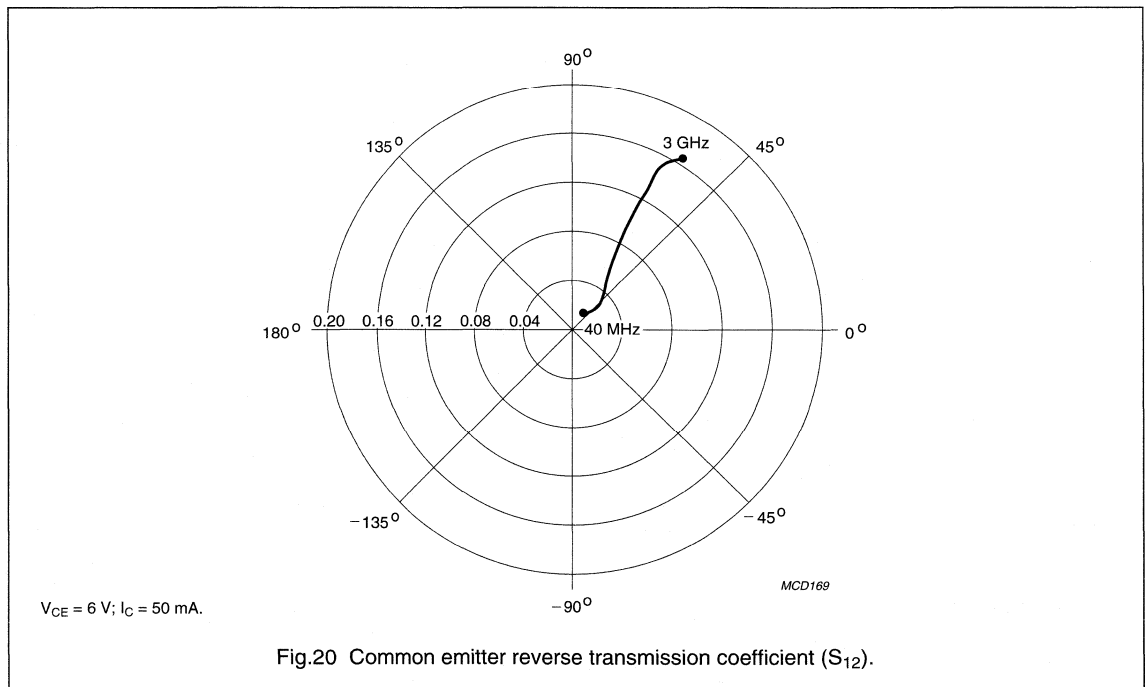
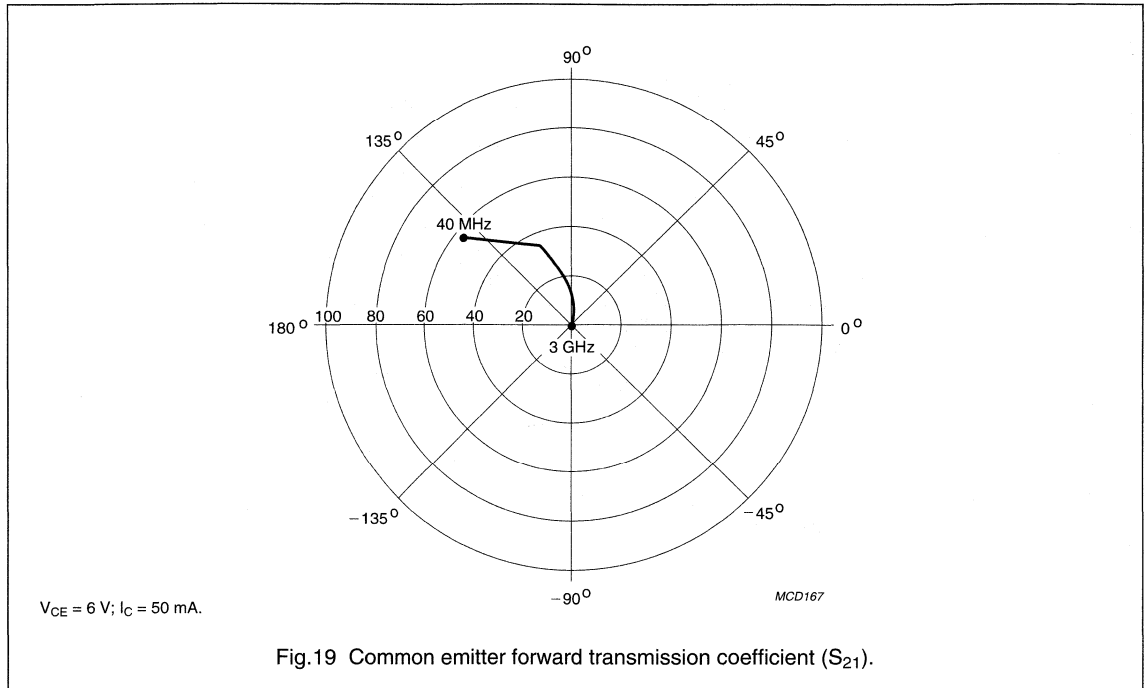
NPN 7 GHz wideband transistor

BFG197; BFG197/X;
BFG197/XR

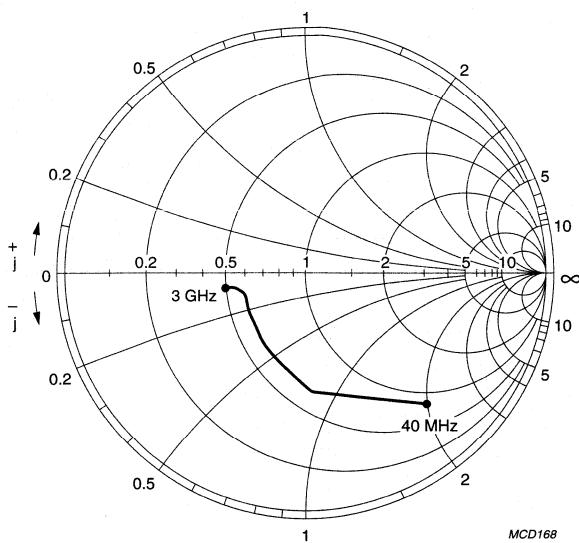


NPN 7 GHz wideband transistor

BFG197; BFG197/X;
BFG197/XR



NPN 7 GHz wideband transistor

BFG197; BFG197/X;
BFG197/XR $V_{CE} = 6\text{ V}; I_C = 50\text{ mA}$.Fig.21 Common emitter output reflection coefficient (S_{22}).

BFG197; BFG197/X; BFG197/XR

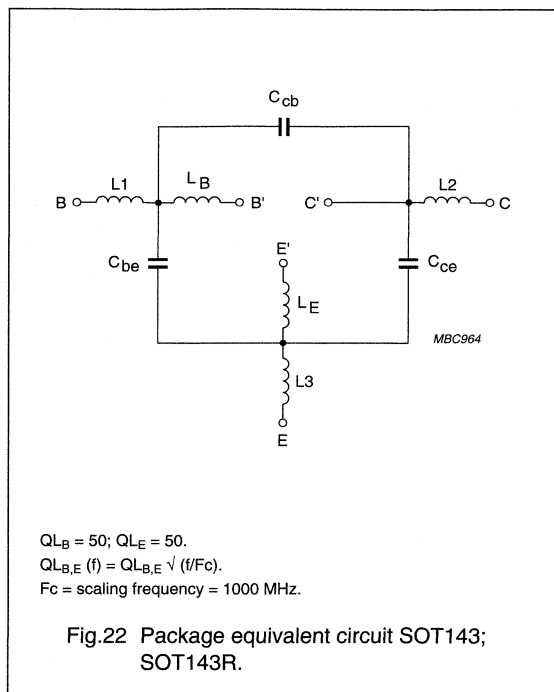
NPN 7 GHz wideband transistor

SPICE parameters for BFQ195 crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|------------|
| 1 | IS | 1.972 | fA |
| 2 | BF | 150.0 | – |
| 3 | NF | 990.8 | m |
| 4 | VAF | 54.72 | V |
| 5 | IKF | 30.00 | A |
| 6 | ISE | 47.82 | fA |
| 7 | NE | 1.580 | – |
| 8 | BR | 165.4 | – |
| 9 | NR | 993.9 | m |
| 10 | VAR | 2.351 | V |
| 11 | IKR | 9.967 | A |
| 12 | ISC | 3.510 | aA |
| 13 | NC | 1.124 | – |
| 14 | RB | 5.000 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 5.000 | Ω |
| 17 | RE | 368.1 | m Ω |
| 18 | RC | 937.2 | m Ω |
| 19 (note 1) | XTB | 0.000 | – |
| 20 (note 1) | EG | 1.110 | EV |
| 21 (note 1) | XTI | 3.000 | – |
| 22 | CJE | 3.388 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 302.9 | m |
| 25 | TF | 11.06 | ps |
| 26 | XTF | 30.02 | – |
| 27 | VTF | 1.649 | V |
| 28 | ITF | 401.9 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 1.190 | pF |
| 31 | VJC | 160.1 | mV |
| 32 | MJC | 89.44 | m |
| 33 | XCJC | 130.0 | m |
| 34 | TR | 2.148 | ns |
| 35 (note 1) | CJS | 0.000 | F |
| 36 (note 1) | VJS | 750.0 | mV |
| 37 (note 1) | MJS | 0.000 | – |
| 38 | FC | 785.9 | m |

Note

1. These parameters have not been extracted, the default values are shown.



List of components (see Fig.22)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 84 | fF |
| C_{cb} | 17 | fF |
| C_{ce} | 191 | fF |
| L1 | 0.12 | nH |
| L2 | 0.21 | nH |
| L3 | 0.06 | nH |
| L_B | 0.95 | nH |
| L_E | 0.40 | nH |

NPN 8 GHz wideband transistor

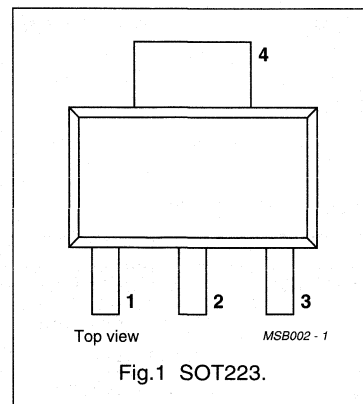
BFG198

DESCRIPTION

NPN planar epitaxial transistor in a plastic SOT223 envelope, intended for wideband amplifier applications. The device features a high gain and excellent output voltage capabilities.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 10 | V |
| I_C | DC collector current | | – | – | 100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ °C}$ (note 1) | – | – | 1 | W |
| h_{FE} | DC current gain | $I_C = 50\text{ mA}$; $V_{CE} = 5\text{ V}$; $T_j = 25\text{ °C}$ | 40 | 90 | – | |
| f_T | transition frequency | $I_C = 50\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 8 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 50\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 18 | – | dB |
| | | $I_C = 50\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| V_o | output voltage | $d_{im} = -60\text{ dB}$; $I_C = 70\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 75\text{ }\Omega$; $T_{amb} = 25\text{ °C}$; $f_{(p+q-r)} = 793.25\text{ MHz}$ | – | 700 | – | mV |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ °C}$ (note 1) | – | 1 | W |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 8 GHz wideband transistor

BFG198

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|--------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 135\text{ °C}$ (note 1) | 40 | K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 5\text{ V}$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 50\text{ mA}; V_{CE} = 5\text{ V}$ | 40 | 90 | – | |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 8\text{ V}; f = 1\text{ MHz}$ | – | 1.5 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 4 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = 8\text{ V}; f = 1\text{ MHz}$ | – | 0.8 | – | pF |
| f_T | transition frequency | $I_C = 50\text{ mA}; V_{CE} = 8\text{ V}; f = 1\text{ GHz}; T_{amb} = 25\text{ °C}$ | – | 8 | – | GHz |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 50\text{ mA}; V_{CE} = 8\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 18 | – | dB |
| | | $I_C = 50\text{ mA}; V_{CE} = 8\text{ V}; f = 800\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| V_o | output voltage | note 2 | – | 750 | – | mV |
| | | note 3 | – | 700 | – | mV |
| d_2 | second order intermodulation distortion | note 4 | – | –55 | – | dB |

Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 70\text{ mA}; V_{CE} = 8\text{ V}; R_L = 75\ \Omega; T_{amb} = 25\text{ °C};$
 $V_p = V_o$ at $d_{im} = -60\text{ dB};$
 $V_q = V_o - 6\text{ dB}; f_p = 445.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_q = 453.25\text{ MHz}; f_r = 455.25\text{ MHz}$
 measured at $f_{(p+q-r)} = 443.25\text{ MHz}.$
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 70\text{ mA}; V_{CE} = 8\text{ V}; R_L = 75\ \Omega; T_{amb} = 25\text{ °C};$
 $V_p = V_o$ at $d_{im} = -60\text{ dB}; f_p = 795.25\text{ MHz};$
 $V_q = V_o - 6\text{ dB}; f_q = 803.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_r = 805.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 793.25\text{ MHz}.$
- $I_C = 50\text{ mA}; V_{CE} = 8\text{ V}; V_o = 50\text{ dBmV};$
 $f_{(p+q)} = 810\text{ MHz}; f_p = 250\text{ MHz}; f_q = 560\text{ MHz}.$

NPN 8 GHz wideband transistor

BFG198

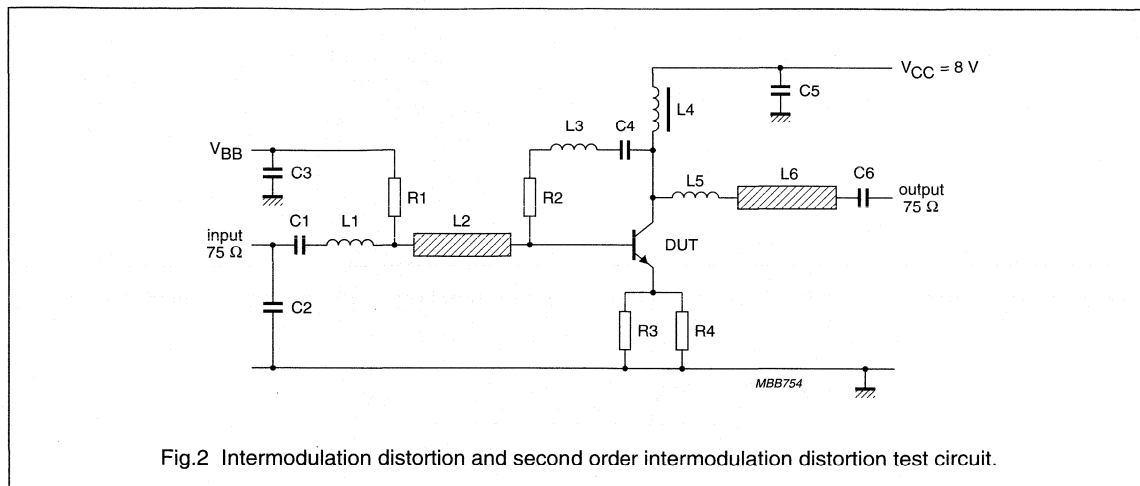


Fig.2 Intermodulation distortion and second order intermodulation distortion test circuit.

List of components (see test circuit)

| DESIGNATION | DESCRIPTION | VALUE | UNIT | DIMENSIONS | CATALOGUE NO. |
|----------------|------------------------------|---------------|----------|---------------------------------------|----------------|
| C2 | multilayer ceramic capacitor | 1.2 | pF | | 2222 851 12128 |
| C1, C4, C6, C7 | multilayer ceramic capacitor | 10 | nF | | 2222 590 08627 |
| C3 | multilayer ceramic capacitor | 10 | nF | | 2222 851 12128 |
| C5 (note 1) | multilayer ceramic capacitor | 10 | nF | | 2222 629 08103 |
| C8 | multilayer ceramic capacitor | 1.5 | pF | | 2222 851 12158 |
| L1 (note 1) | 1.5 turns 0.4 mm copper wire | | | int. dia. 3 mm; winding pitch 1 mm | |
| L2 | microstripline | 75 | Ω | length 22 mm; width 2.5 mm | |
| L3 (note 1) | 0.4 mm copper wire | ≈ 24 | nH | length 30 mm | |
| L4 (note 1) | 0.4 mm copper wire | ≈ 3.6 | nH | length 4 mm | |
| L5 | microstripline | 75 | Ω | length 19 mm; width 2.5 mm | |
| L6 | Ferroxcube choke | 5 | μ H | | 3122 108 20153 |
| R1 | metal film resistor | 10 | Ω | | 2322 180 73103 |
| R2 (note 1) | metal film resistor | 220 | Ω | | 2322 180 73221 |
| R3, R4 | metal film resistor | 30 | Ω | | 2322 180 73309 |

Note

- Components C5, L1, L3, L4, and R2 are mounted on the underside of the PCB. The circuit is constructed on a double copper-clad printed circuit board with PTFE dielectric ($\epsilon_r = 2.2$); thickness $\frac{1}{16}$ inch; thickness of copper sheet $2 \times 35 \mu\text{m}$; see Fig.2.

NPN 8 GHz wideband transistor

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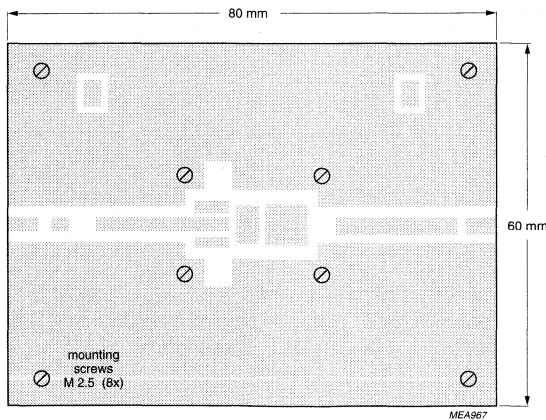
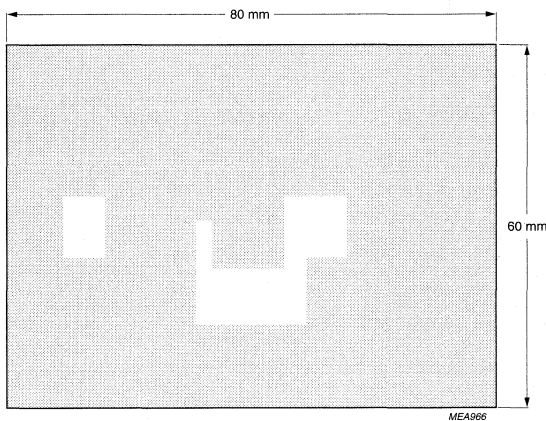
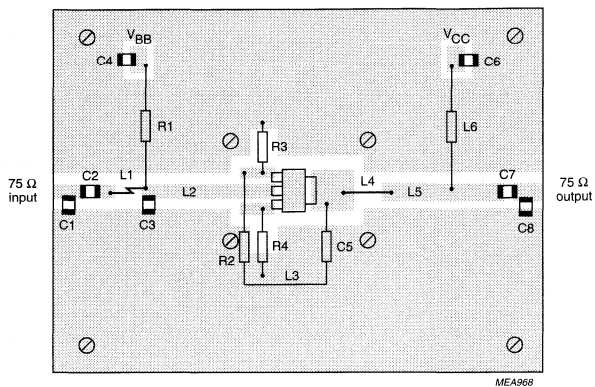
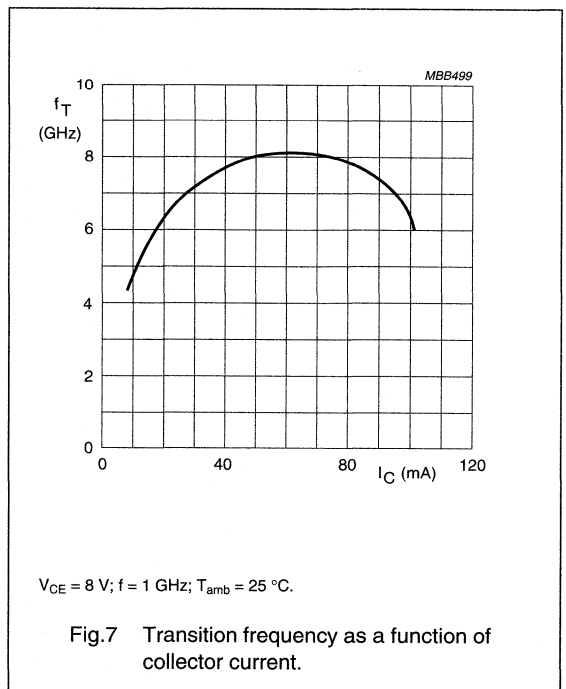
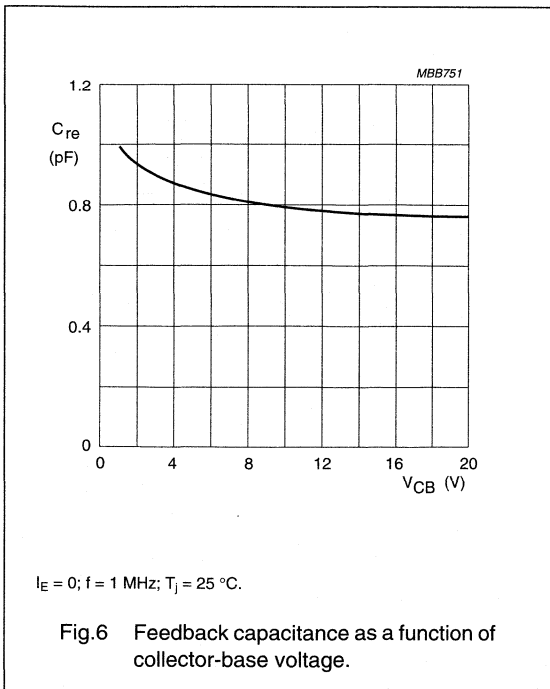
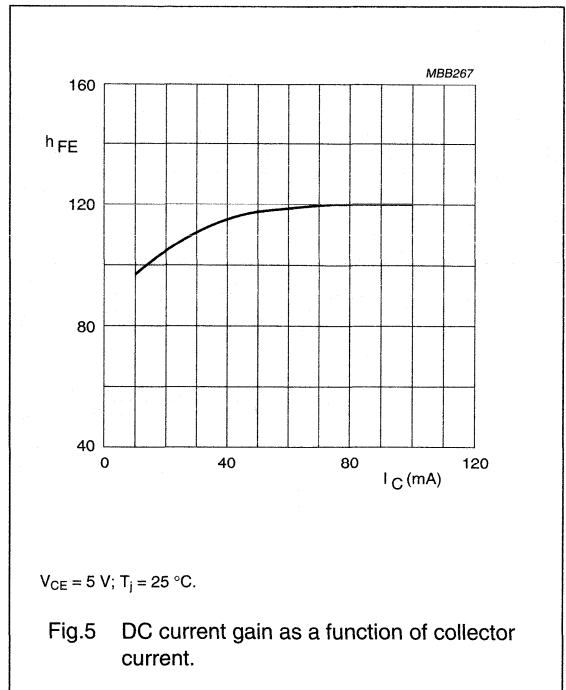
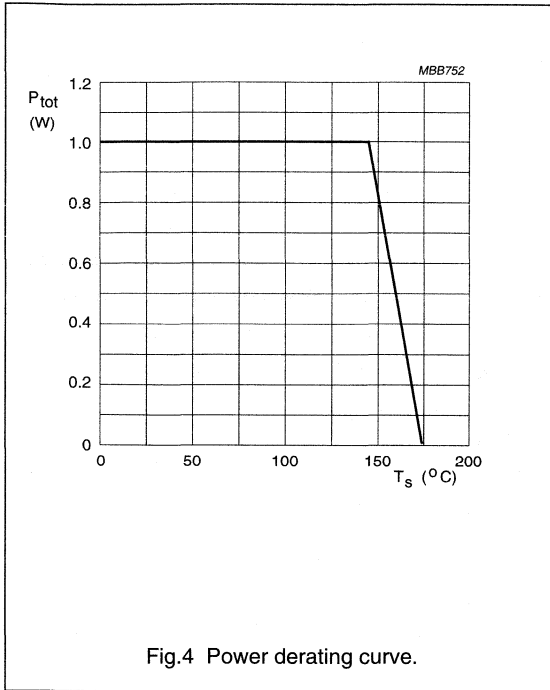


Fig.3 Intermodulation distortion and second order intermodulation distortion printed-circuit board.

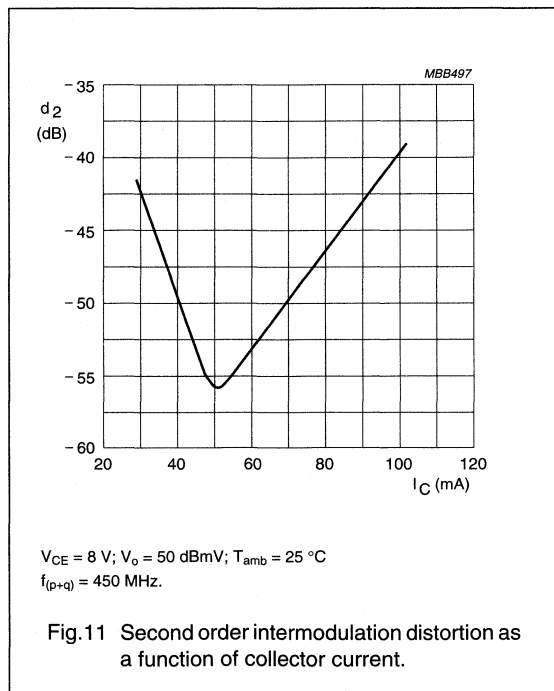
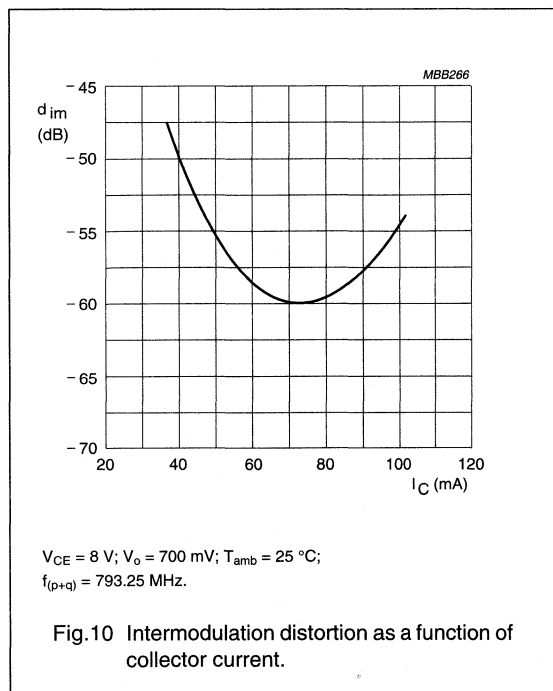
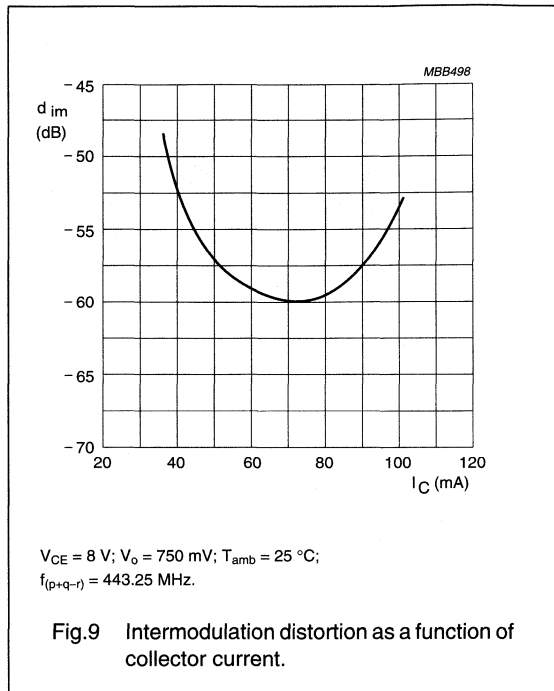
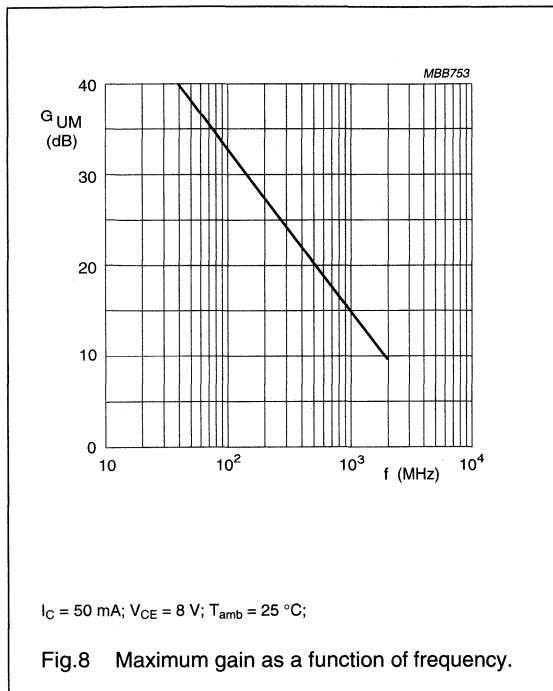
NPN 8 GHz wideband transistor

BFG198



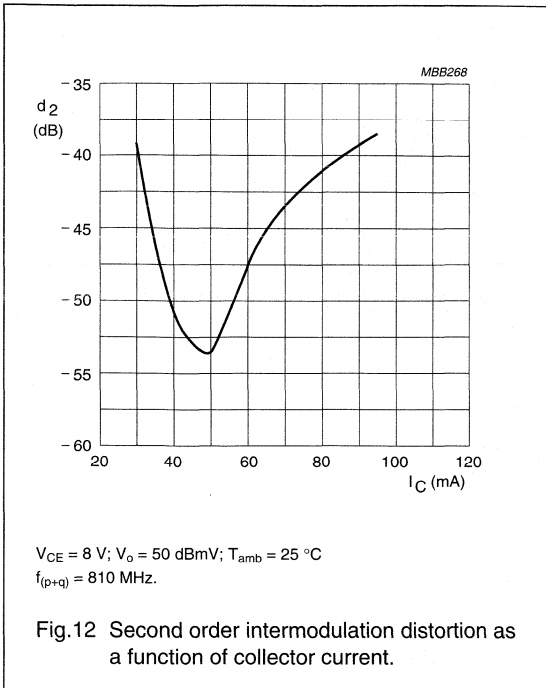
NPN 8 GHz wideband transistor

BFG198



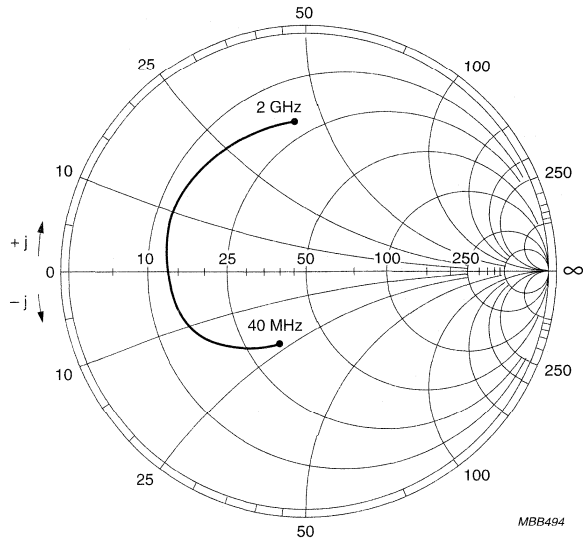
NPN 8 GHz wideband transistor

BFG198



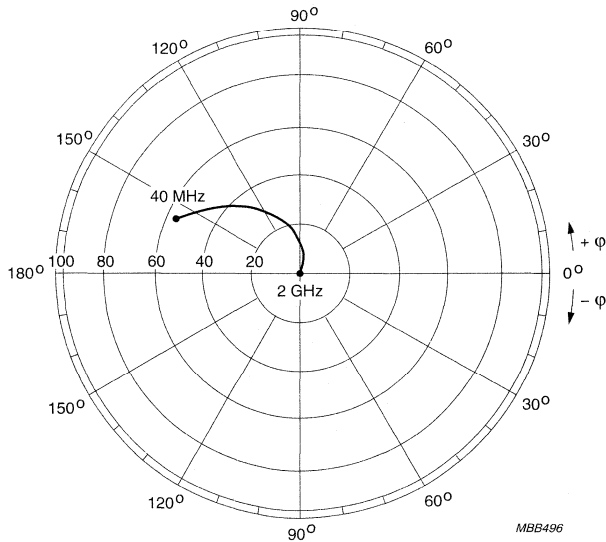
NPN 8 GHz wideband transistor

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$I_C = 50 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$; $Z_0 = 50 \text{ } \Omega$.

Fig.13 Common emitter input reflection coefficient (S_{11}).

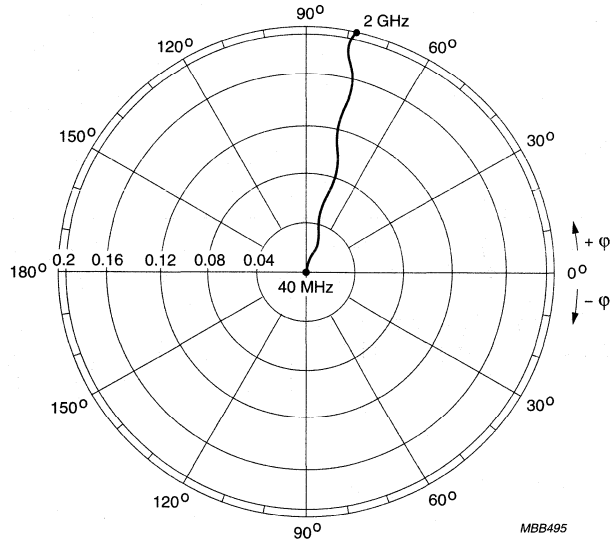


$I_C = 50 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.14 Common emitter forward transmission coefficient (S_{21}).

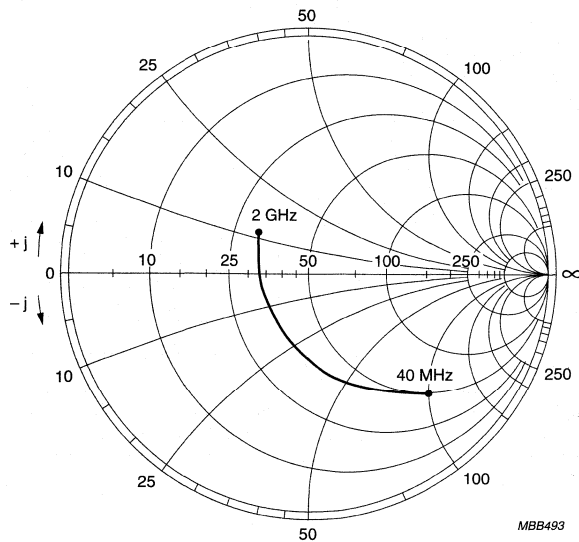
NPN 8 GHz wideband transistor

BFG198



$I_C = 50 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.15 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 50 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$; $Z_0 = 50 \text{ } \Omega$.

Fig.16 Common emitter output reflection coefficient (S_{22}).

NPN 17 GHz wideband transistor

BFG403W

FEATURES

- Low current
- Very high power gain
- Low noise figure
- High transition frequency
- Very low feedback capacitance.

APPLICATIONS

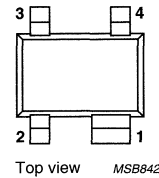
- Pager front ends
- RF front end
- Wideband applications, e.g. analog and digital cellular telephones, cordless telephones (PHS, DECT, etc.)
- Radar detectors.

DESCRIPTION

NPN double polysilicon wideband transistor with buried layer for low voltage applications in a plastic, 4-pin dual-emitter SOT343R package.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



Marking code: P3.

Fig.1 Simplified outline SOT343R.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 10 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 4.5 | V |
| I_C | collector current (DC) | | – | 3 | 3.6 | mA |
| P_{tot} | total power dissipation | $T_s \leq 140\text{ }^\circ\text{C}$ | – | – | 16 | mW |
| h_{FE} | DC current gain | $I_C = 3\text{ mA}; V_{CE} = 2\text{ V}; T_j = 25\text{ }^\circ\text{C}$ | 50 | 80 | 150 | |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 2\text{ V}; f = 1\text{ MHz}$ | – | 20 | – | fF |
| f_T | transition frequency | $I_C = 3\text{ mA}; V_{CE} = 2\text{ V}; f = 2\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 17 | – | GHz |
| G_{max} | maximum power gain | $I_C = 3\text{ mA}; V_{CE} = 2\text{ V}; f = 2\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 22 | – | dB |
| F | noise figure | $I_C = 1\text{ mA}; V_{CE} = 2\text{ V}; f = 900\text{ MHz}; \Gamma_S = \Gamma_{opt}$ | – | 1 | – | dB |

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

NPN 17 GHz wideband transistor

BFG403W

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

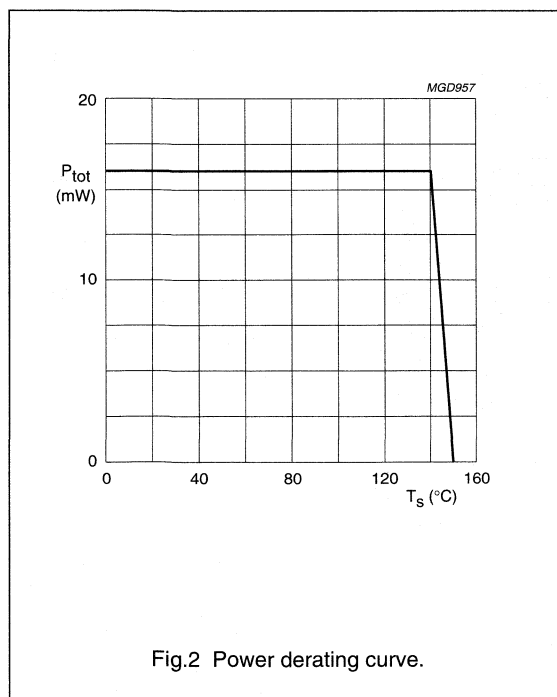
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 10 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 4.5 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 1 | V |
| I_C | collector current (DC) | | – | 3.6 | mA |
| P_{tot} | total power dissipation | $T_s \leq 140$ °C; note 1; see Fig.2 | – | 16 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | operating junction temperature | | – | 150 | °C |

Note

- T_s is the temperature at the soldering point of the emitter pins.

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | 820 | K/W |



NPN 17 GHz wideband transistor

BFG403W

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

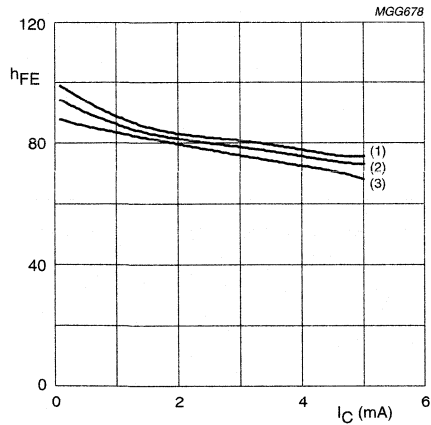
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---------------------------------------|--|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\ \mu\text{A}; I_E = 0$ | 10 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 1\ \text{mA}; I_B = 0$ | 4.5 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 2.5\ \mu\text{A}; I_C = 0$ | 1 | – | – | V |
| I_{CBO} | collector-base leakage current | $I_E = 0; V_{CB} = 4.5\ \text{V}$ | – | – | 15 | nA |
| h_{FE} | DC current gain | $I_C = 3\ \text{mA}; V_{CE} = 2\ \text{V};$ see Fig.3 | 50 | 80 | 150 | |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 2\ \text{V}; f = 1\ \text{MHz}$ | – | 170 | – | fF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = 0.5\ \text{V}; f = 1\ \text{MHz}$ | – | 315 | – | fF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 2\ \text{V}; f = 1\ \text{MHz};$ see Fig.4 | – | 20 | – | fF |
| f_T | transition frequency | $I_C = 3\ \text{mA}; V_{CE} = 2\ \text{V}; f = 2\ \text{GHz};$ $T_{amb} = 25\text{ }^\circ\text{C};$ see Fig.5 | – | 17 | – | GHz |
| G_{max} | maximum power gain; note 1 | $I_C = 0.5\ \text{mA}; V_{CE} = 1\ \text{V}; f = 900\ \text{MHz};$ $T_{amb} = 25\text{ }^\circ\text{C};$ see Figs 6 and 8 | – | 20 | – | dB |
| | | $I_C = 3\ \text{mA}; V_{CE} = 2\ \text{V}; f = 2\ \text{GHz};$ $T_{amb} = 25\text{ }^\circ\text{C};$ see Figs 7 and 8 | – | 22 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 0.5\ \text{mA}; V_{CE} = 1\ \text{V}; f = 900\ \text{MHz};$ $T_{amb} = 25\text{ }^\circ\text{C};$ see Fig.8 | – | 5 | – | dB |
| | | $I_C = 3\ \text{mA}; V_{CE} = 2\ \text{V}; f = 2\ \text{GHz};$ $T_{amb} = 25\text{ }^\circ\text{C};$ see Fig.8 | – | 14 | – | dB |
| F | noise figure | $I_C = 1\ \text{mA}; V_{CE} = 2\ \text{V}; f = 900\ \text{MHz};$ $\Gamma_S = \Gamma_{opt};$ see Fig.13 | – | 1 | – | dB |
| | | $I_C = 1\ \text{mA}; V_{CE} = 2\ \text{V}; f = 2\ \text{GHz};$ $\Gamma_S = \Gamma_{opt};$ see Fig.13 | – | 1.6 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 1\ \text{mA}; V_{CE} = 1\ \text{V}; f = 900\ \text{MHz};$ $Z_S = Z_{S\ opt}; Z_L = Z_{L\ opt};$ note 2 | – | –5 | – | dBm |
| ITO | third order intercept point | $I_C = 1\ \text{mA}; V_{CE} = 1\ \text{V}; f = 900\ \text{MHz};$ $Z_S = Z_{S\ opt}; Z_L = Z_{L\ opt};$ note 2 | – | 6 | – | dBm |

Notes

- G_{max} is the maximum power gain, if $K > 1$. If $K < 1$ then $G_{max} = \text{MSG}$; see Figs 6; 7 and 8.
- Z_S is optimized for noise; Z_L is optimized for gain.

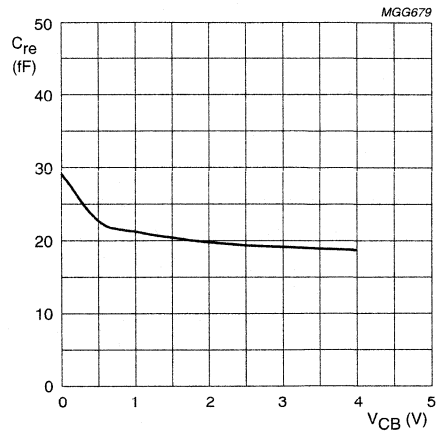
NPN 17 GHz wideband transistor

BFG403W



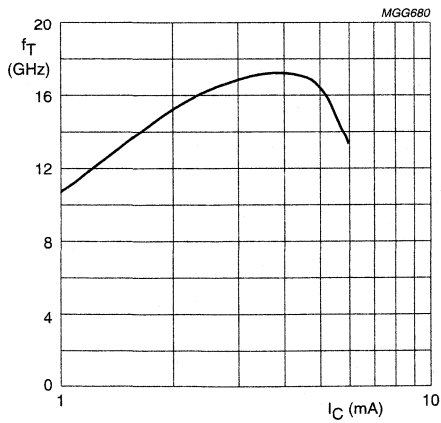
- (1) $V_{CE} = 3$ V.
- (2) $V_{CE} = 2$ V.
- (3) $V_{CE} = 1$ V.

Fig.3 DC current gain as a function of collector current; typical values.



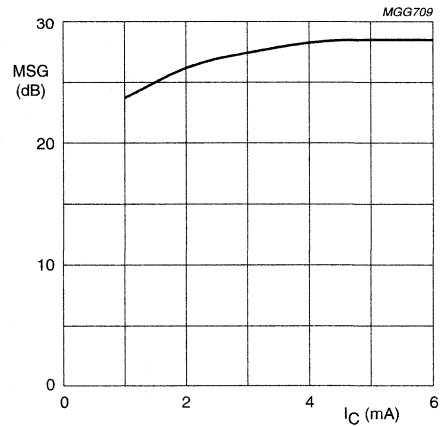
$I_C = 0$; $f = 1$ MHz.

Fig.4 Feedback capacitance as a function of collector-base voltage; typical values.



$V_{CE} = 2$ V; $f = 2$ GHz; $T_{amb} = 25$ °C.

Fig.5 Transition frequency as a function of collector current; typical values.

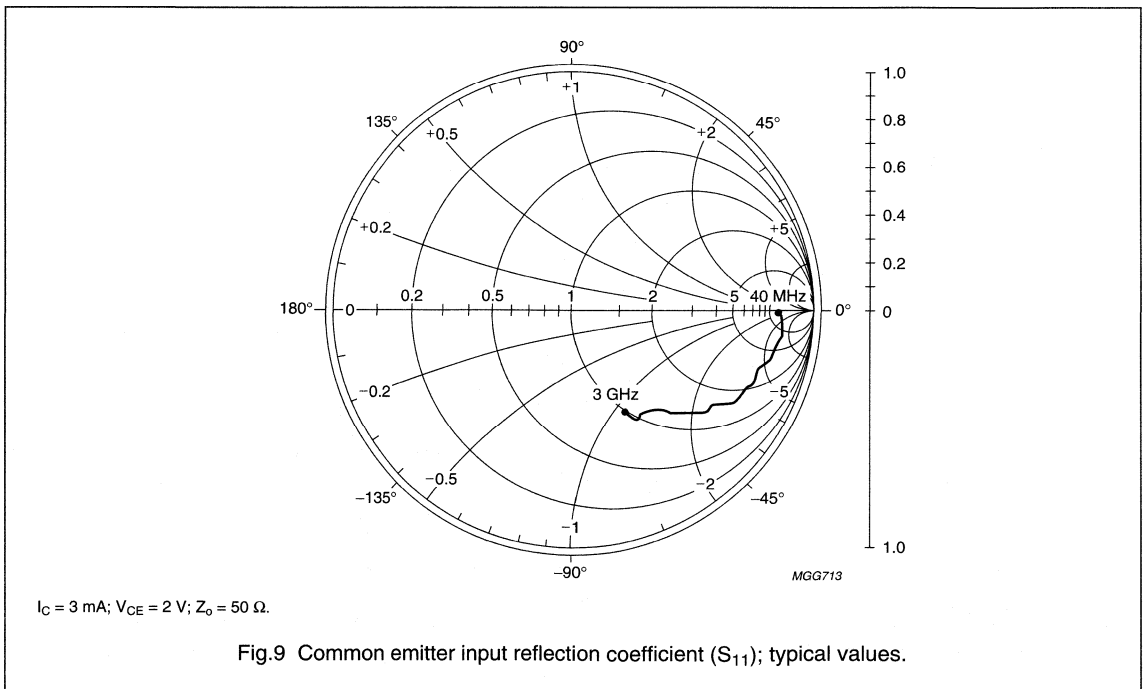
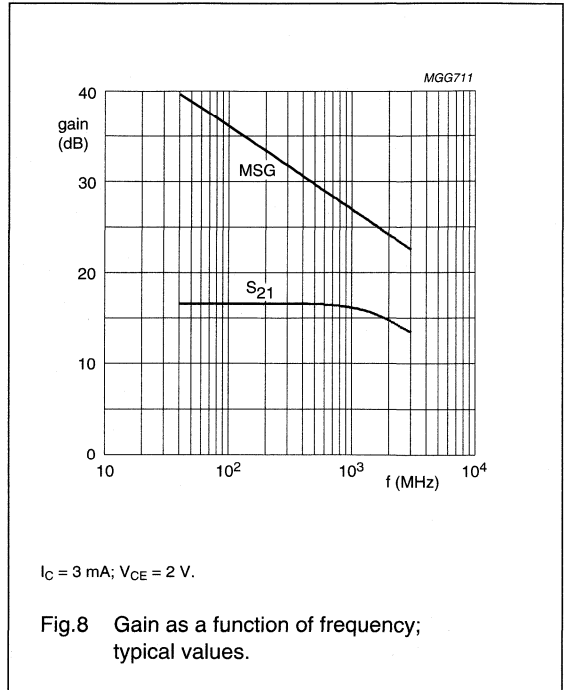
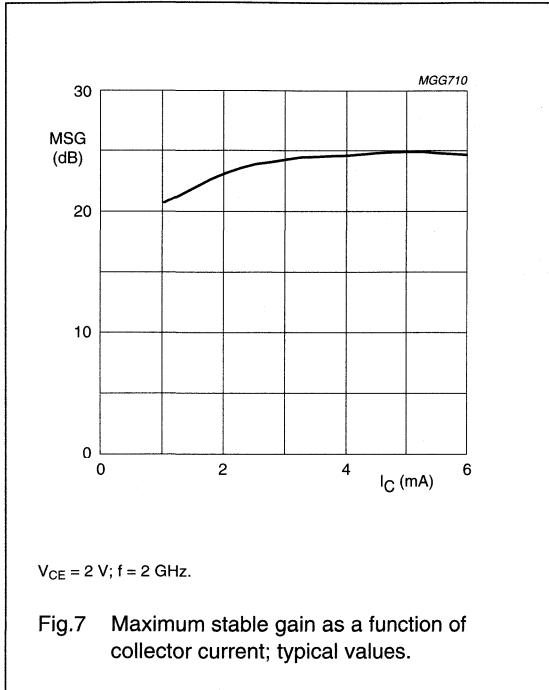


$V_{CE} = 2$ V; $f = 900$ MHz.

Fig.6 Maximum stable gain as a function of collector current; typical values.

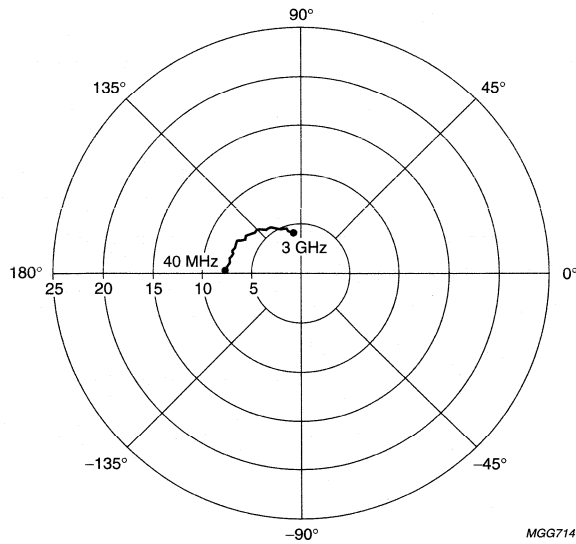
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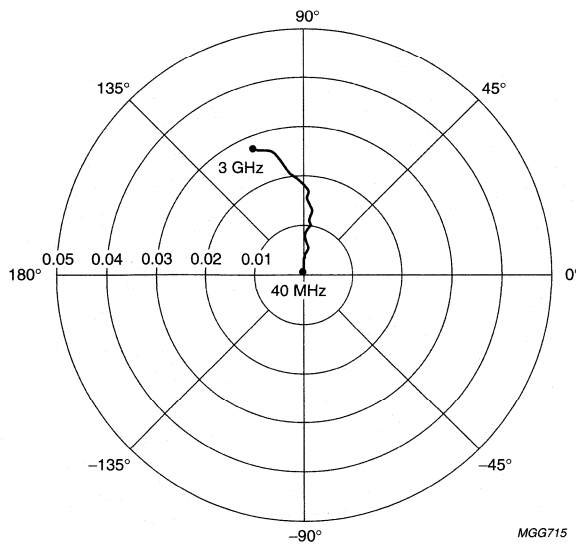
BFG403W



MGG714

$I_C = 3 \text{ mA}; V_{CE} = 2 \text{ V}.$

Fig.10 Common emitter forward transmission coefficient (S_{21}); typical values.



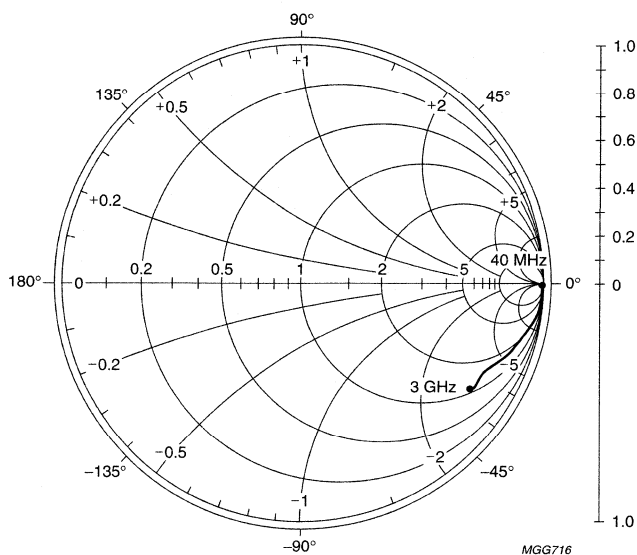
MGG715

$I_C = 3 \text{ mA}; V_{CE} = 2 \text{ V}.$

Fig.11 Common emitter reverse transmission coefficient (S_{12}); typical values.

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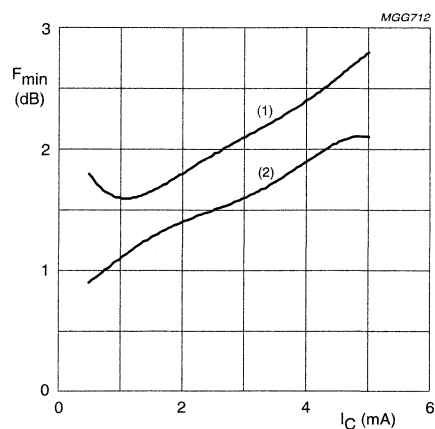
$I_C = 3 \text{ mA}$; $V_{CE} = 2 \text{ V}$; $Z_0 = 50 \Omega$.

Fig.12 Common emitter output reflection coefficient (S_{22}); typical values.

Noise data

$V_{CE} = 2 \text{ V}$; typical values.

| f (MHz) | I_C (mA) | F_{min} (dB) | Γ_{mag} | Γ_{angle} | r_n (Ω) |
|---------|------------|----------------|----------------|------------------|--------------------|
| 900 | 0.5 | 0.9 | 0.91 | 4.7 | 1.41 |
| | 1 | 1.1 | 0.83 | 5.1 | 1.12 |
| | 2 | 1.4 | 0.71 | 5.1 | 0.97 |
| | 3 | 1.6 | 0.62 | 5.0 | 0.88 |
| | 4 | 1.9 | 0.56 | 4.9 | 0.84 |
| | 5 | 2.1 | 0.50 | 4.2 | 0.82 |
| 2000 | 0.5 | 1.8 | 0.71 | 27.5 | 1.47 |
| | 1 | 1.6 | 0.74 | 26.1 | 1.11 |
| | 2 | 1.8 | 0.64 | 26.3 | 0.93 |
| | 3 | 2.1 | 0.56 | 26.1 | 0.91 |
| | 4 | 2.4 | 0.48 | 26.7 | 0.9 |
| | 5 | 2.8 | 0.45 | 25.8 | 0.85 |



- (1) $V_{CE} = 2 \text{ V}$; $f = 2 \text{ GHz}$.
 (2) $V_{CE} = 2 \text{ V}$; $f = 900 \text{ MHz}$.

Fig.13 Minimum noise figure as a function of the collector current; typical values.

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SPICE parameters for the BFG403W die

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|----------|
| 1 | IS | 5.554 | aA |
| 2 | BF | 145.0 | – |
| 3 | NF | 0.993 | – |
| 4 | VAF | 31.12 | V |
| 5 | IKF | 35.75 | mA |
| 6 | ISE | 35.35 | fA |
| 7 | NE | 3.000 | – |
| 8 | BR | 11.37 | – |
| 9 | NR | 0.985 | – |
| 10 | VAR | 1.874 | V |
| 11 | IKR | 0.014 | A |
| 12 | ISC | 57.08 | aA |
| 13 | NC | 1.546 | – |
| 14 | RB | 122.4 | Ω |
| 15 | IRB | 0.000 | A |
| 16 | RBM | 52.45 | Ω |
| 17 | RE | 1.511 | Ω |
| 18 | RC | 15.12 | Ω |
| 19 (1) | XTB | 1.500 | – |
| 20 (1) | EG | 1.110 | eV |
| 21 (1) | XTI | 3.000 | – |
| 22 | CJE | 36.61 | fF |
| 23 | VJE | 900.0 | mV |
| 24 | MJE | 0.346 | – |
| 25 | TF | 4.122 | ps |
| 26 | XTF | 68.20 | – |
| 27 | VTF | 2.004 | V |
| 28 | ITF | 0.179 | A |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 16.21 | fF |
| 31 | VJC | 556.9 | mV |
| 32 | MJC | 0.207 | – |
| 33 | XCJC | 0.500 | – |
| 34 (1) | TR | 00.00 | ns |
| 35 (1) | CJS | 78.59 | fF |
| 36 (1) | VJS | 418.3 | mV |
| 37 (1) | MJS | 0.239 | – |
| 38 | FC | 0.550 | – |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|----------|
| 39 (2)(3) | C_{bp} | 145 | fF |
| 40 (2) | R_{sb1} | 25 | Ω |
| 41 (3) | R_{sb2} | 19 | Ω |

Notes

- These parameters have not been extracted, the default values are shown.
- Bonding pad capacity C_{bp} in series with substrate resistance R_{sb1} between B' and E'.
- Bonding pad capacity C_{bp} in series with substrate resistance R_{sb2} between C' and E'.

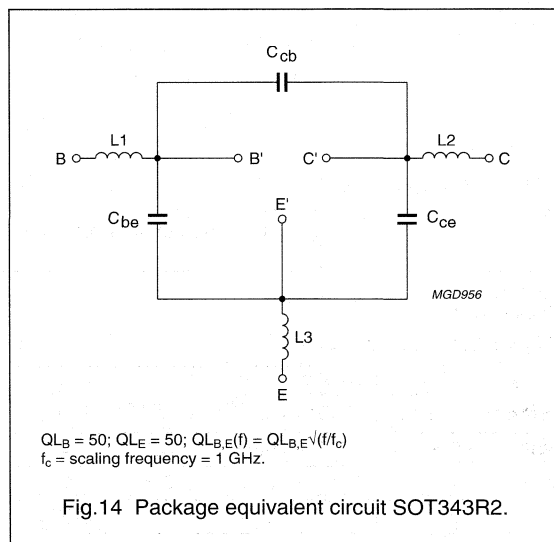


Fig.14 Package equivalent circuit SOT343R2.

List of components (see Fig.14)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 80 | fF |
| C_{cb} | 2 | fF |
| C_{ce} | 80 | fF |
| L1 | 1.1 | nH |
| L2 | 1.1 | nH |
| L3 (note 1) | 0.25 | nH |

Note

- External emitter inductance to be added separately due to the influence of the printed-circuit board.

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FEATURES

- Very high power gain
- Low noise figure
- High transition frequency
- Emitter is thermal lead
- Low feedback capacitance.

APPLICATIONS

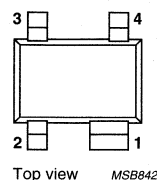
- RF front end
- Wideband applications, e.g. analog and digital cellular telephones, cordless telephones (PHS, DECT, etc.)
- Radar detectors
- Pagers
- Satellite television tuners (SATV)
- High frequency oscillators.

DESCRIPTION

NPN double polysilicon wideband transistor with buried layer for low voltage applications in a plastic, 4-pin dual-emitter SOT343R package.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



Marking code: P4.

Fig. 1 Simplified outline SOT343R.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 10 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 4.5 | V |
| I_C | collector current (DC) | | – | 10 | 12 | mA |
| P_{tot} | total power dissipation | $T_s \leq 110\text{ }^\circ\text{C}$ | – | – | 54 | mW |
| h_{FE} | DC current gain | $I_C = 10\text{ mA}$; $V_{CE} = 2\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$ | 50 | 80 | 150 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 2\text{ V}$; $f = 1\text{ MHz}$ | – | 45 | – | fF |
| f_T | transition frequency | $I_C = 10\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 22 | – | GHz |
| G_{max} | maximum power gain | $I_C = 10\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 21 | – | dB |
| F | noise figure | $I_C = 1\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $\Gamma_S = \Gamma_{opt}$ | – | 1.2 | – | dB |

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

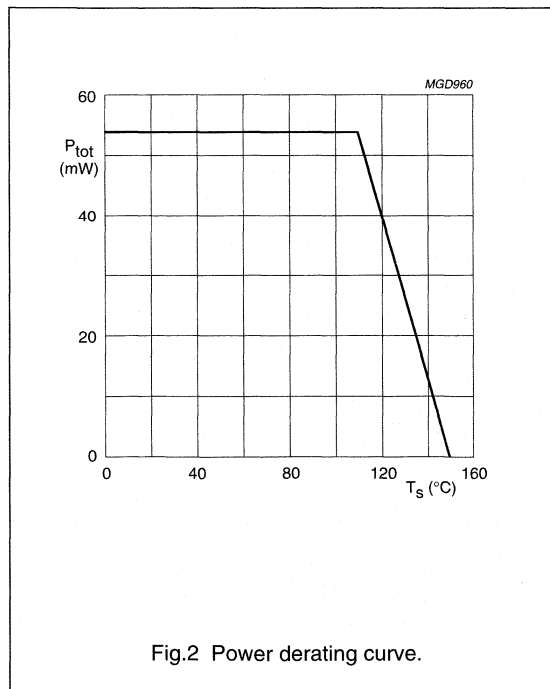
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|--|------|------|------------------|
| V_{CB0} | collector-base voltage | open emitter | – | 10 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 4.5 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 1 | V |
| I_C | collector current (DC) | | – | 12 | mA |
| P_{tot} | total power dissipation | $T_s \leq 110\text{ }^\circ\text{C}$; note 1; see Fig.2 | – | 54 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | operating junction temperature | | – | 150 | $^\circ\text{C}$ |

Note

- T_s is the temperature at the soldering point of the emitter pins.

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | 750 | K/W |



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CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

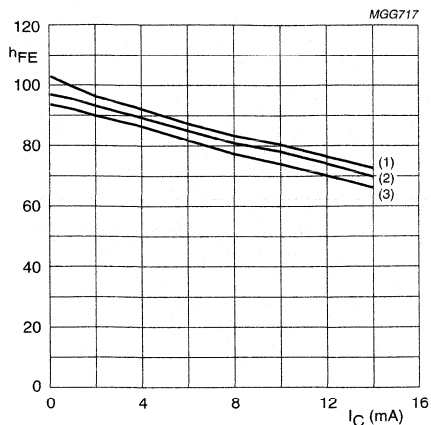
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---------------------------------------|--|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\text{ }\mu\text{A}$; $I_E = 0$ | 10 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 1\text{ mA}$; $I_B = 0$ | 4.5 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 2.5\text{ }\mu\text{A}$; $I_C = 0$ | 1 | – | – | V |
| I_{CBO} | collector-base leakage current | $I_E = 0$; $V_{CB} = 4.5\text{ V}$ | – | – | 15 | nA |
| h_{FE} | DC current gain | $I_C = 10\text{ mA}$; $V_{CE} = 2\text{ V}$; see Fig.3 | 50 | 80 | 150 | |
| C_c | collector capacitance | $I_E = I_e = 0$; $V_{CB} = 2\text{ V}$; $f = 1\text{ MHz}$ | – | 220 | – | fF |
| C_e | emitter capacitance | $I_C = I_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 400 | – | fF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 2\text{ V}$; $f = 1\text{ MHz}$; see Fig.4 | – | 45 | – | fF |
| f_T | transition frequency | $I_C = 10\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see Fig.5 | – | 22 | – | GHz |
| G_{max} | maximum power gain; note 1 | $I_C = 10\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see Figs 7 and 8 | – | 21 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 10\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see Fig.8 | – | 18 | – | dB |
| F | noise figure | $I_C = 1\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 900\text{ MHz}$; $\Gamma_S = \Gamma_{opt}$; see Fig.13 | – | 0.9 | – | dB |
| | | $I_C = 1\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $\Gamma_S = \Gamma_{opt}$; see Fig.13 | – | 1.2 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 10\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $Z_S = Z_{S\text{ opt}}$; $Z_L = Z_{L\text{ opt}}$; note 2 | – | 5 | – | dBm |
| ITO | third order intercept point | $I_C = 10\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $Z_S = Z_{S\text{ opt}}$; $Z_L = Z_{L\text{ opt}}$; note 2 | – | 15 | – | dBm |

Notes

- G_{max} is the maximum power gain, if $K > 1$. If $K < 1$ then $G_{max} = MSG$; see Figs 6; 7 and 8.
- Z_S is optimized for noise; Z_L is optimized for gain.

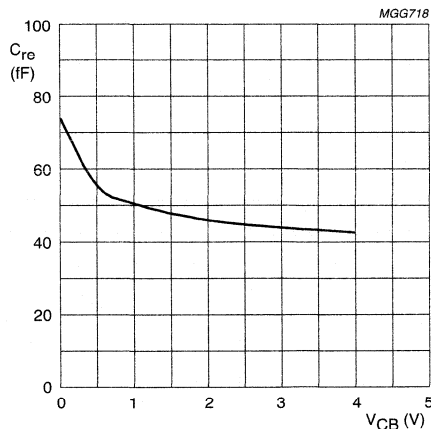
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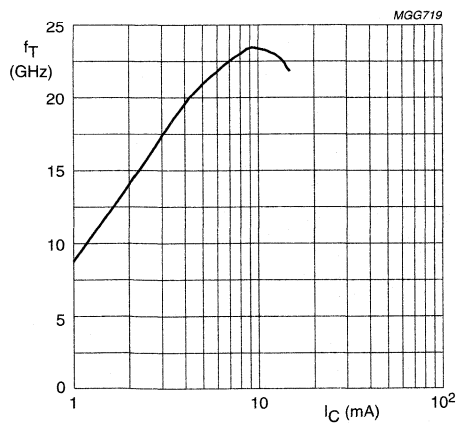
- (1) $V_{CE} = 3$ V.
- (2) $V_{CE} = 2$ V.
- (3) $V_{CE} = 1$ V.

Fig.3 DC current gain as a function of collector current; typical values.



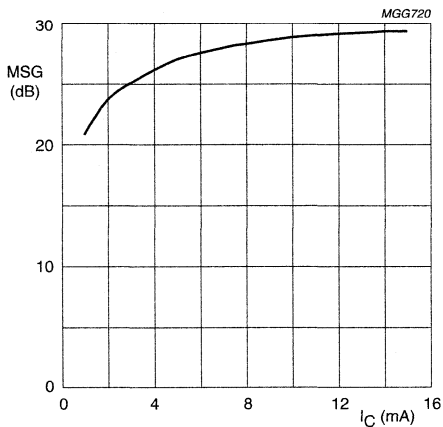
$I_C = 0$; $f = 1$ MHz.

Fig.4 Feedback capacitance as a function of collector-base voltage; typical values.



$V_{CE} = 2$ V; $f = 2$ GHz; $T_{amb} = 25$ °C.

Fig.5 Transition frequency as a function of collector current; typical values.

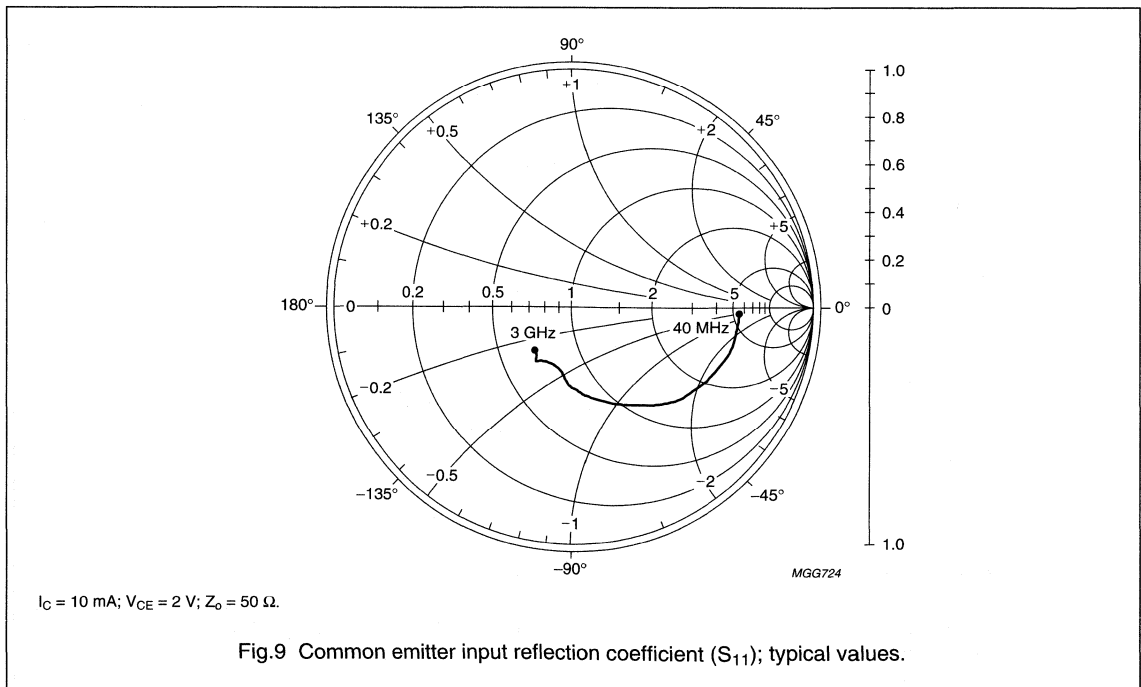
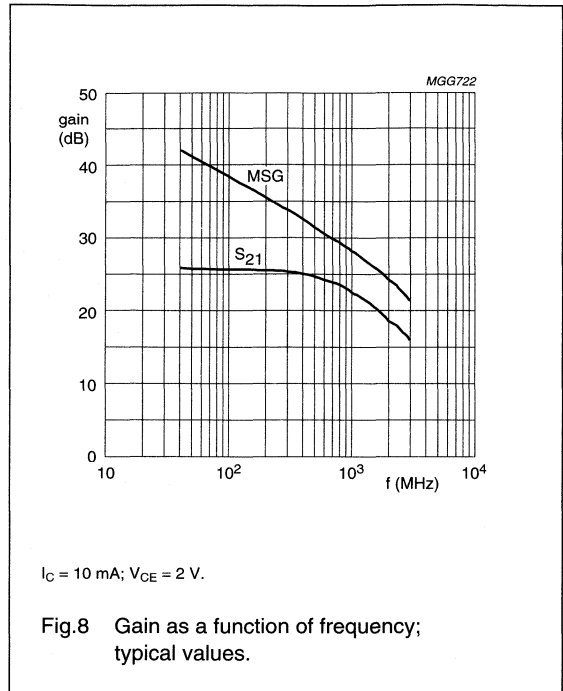
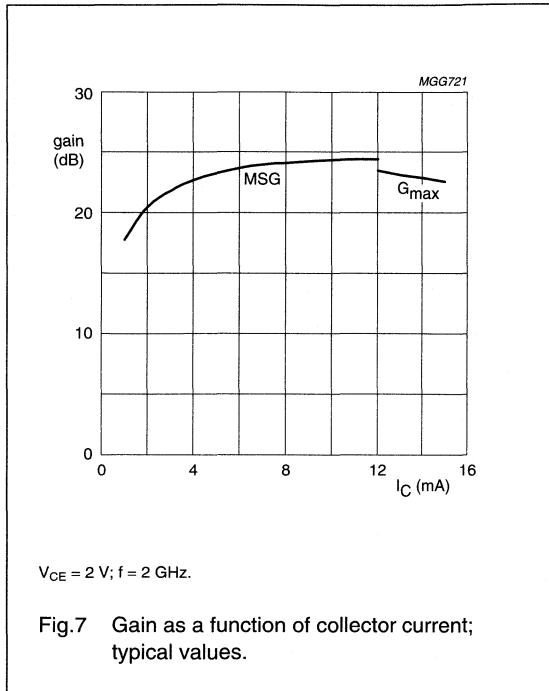


$V_{CE} = 2$ V; $f = 900$ MHz.

Fig.6 Maximum stable gain as a function of collector current; typical values.

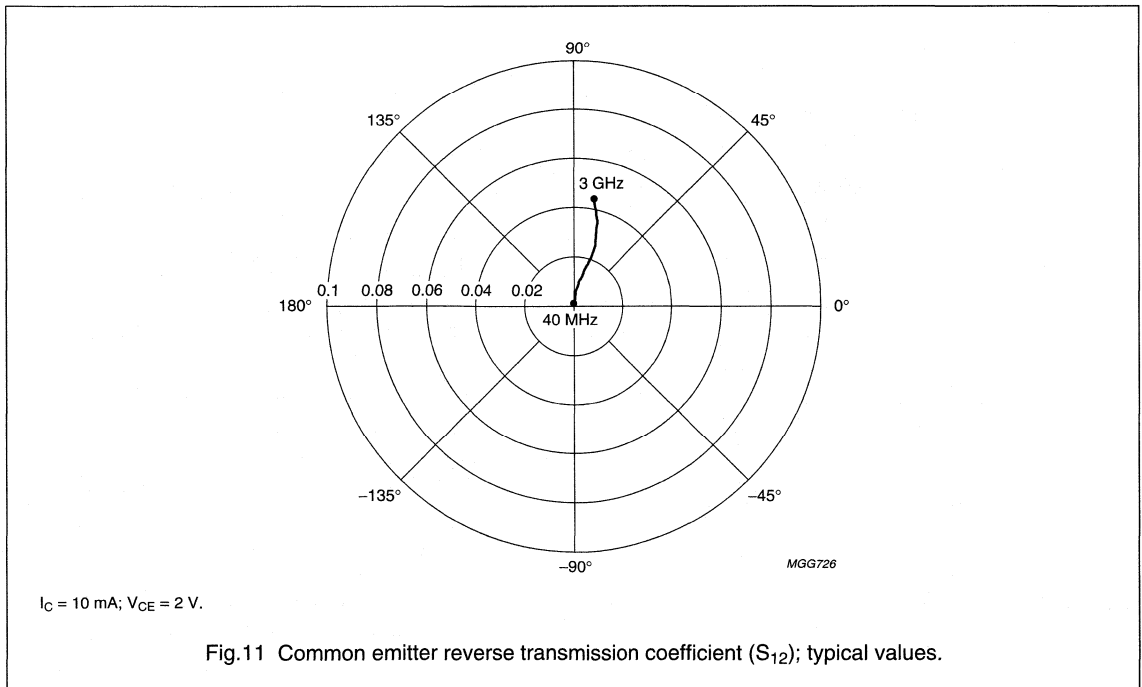
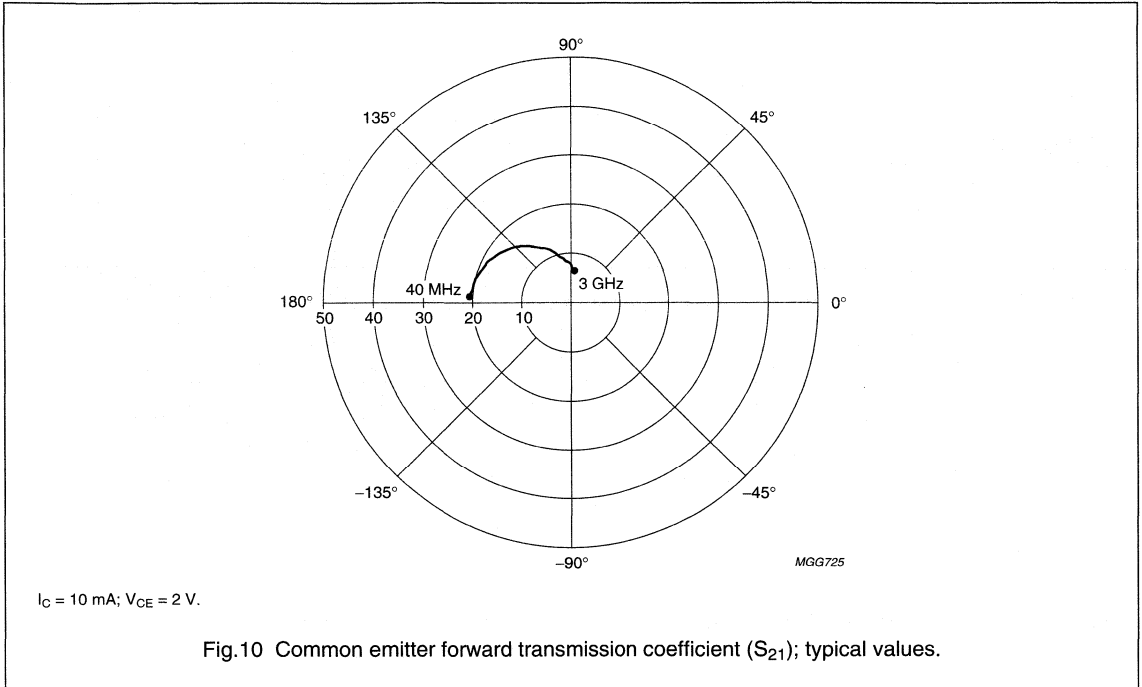
NPN 22 GHz wideband transistor

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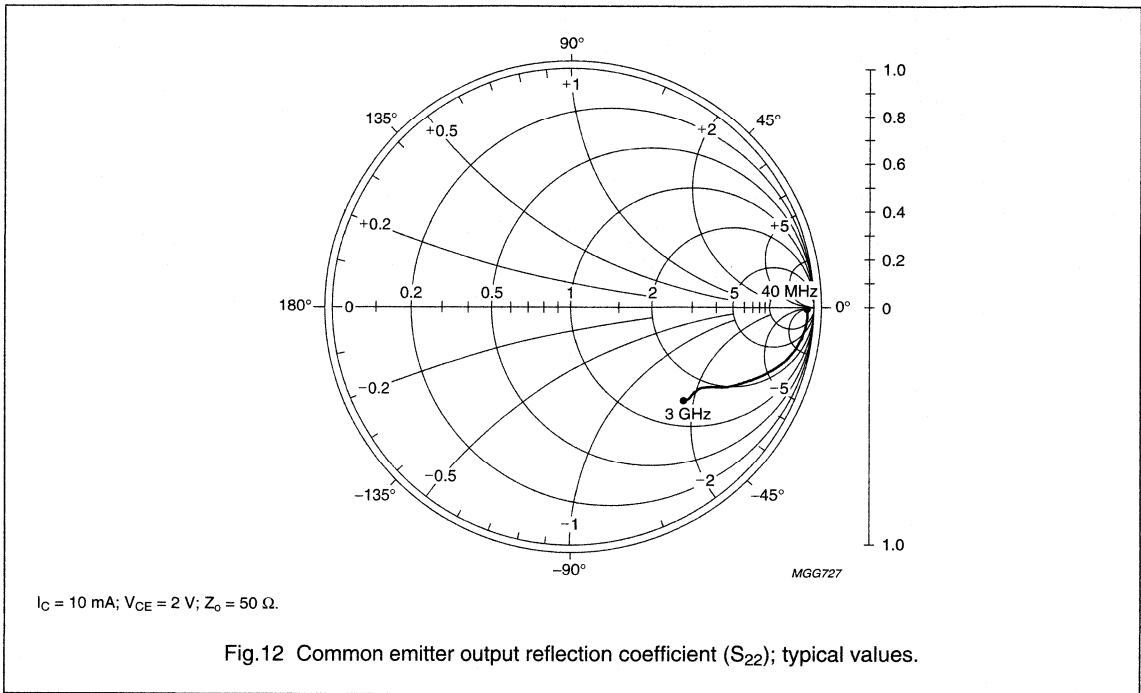
NPN 22 GHz wideband transistor

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NPN 22 GHz wideband transistor

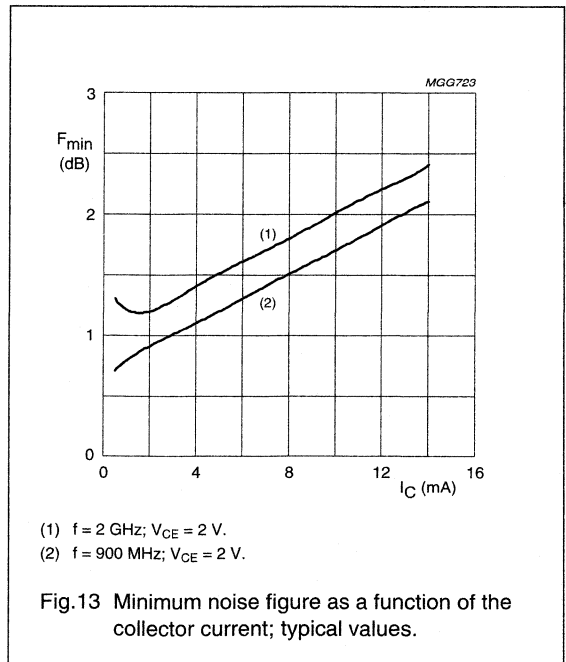
BFG410W



Noise data

$V_{CE} = 2 \text{ V}$; typical values.

| f (MHz) | I_C (mA) | F_{min} (dB) | Γ_{mag} | Γ_{angle} | r_n (Ω) |
|---------|------------|----------------|----------------|------------------|--------------------|
| 900 | 1 | 0.8 | 0.73 | 11.2 | 0.56 |
| | 2 | 0.9 | 0.58 | 10.1 | 0.43 |
| | 4 | 1.1 | 0.40 | 10.1 | 0.33 |
| | 6 | 1.3 | 0.28 | 11.0 | 0.30 |
| | 8 | 1.5 | 0.20 | 8.0 | 0.30 |
| | 10 | 1.7 | 0.14 | 10.5 | 0.27 |
| | 12 | 1.9 | 0.06 | 10.1 | 0.25 |
| | 14 | 2.1 | 0.05 | 14.2 | 0.26 |
| 2000 | 1 | 1.2 | 0.64 | 35.7 | 0.57 |
| | 2 | 1.2 | 0.50 | 35.8 | 0.44 |
| | 4 | 1.4 | 0.34 | 34.4 | 0.37 |
| | 6 | 1.6 | 0.25 | 33.7 | 0.34 |
| | 8 | 1.8 | 0.17 | 34.5 | 0.35 |
| | 10 | 2.0 | 0.12 | 35.8 | 0.34 |
| | 12 | 2.2 | 0.05 | 38.0 | 0.35 |
| | 14 | 2.4 | 0.03 | 44.8 | 0.34 |



NPN 22 GHz wideband transistor

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SPICE parameters for the BFG410W die

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|------------|
| 1 | IS | 19.42 | aA |
| 2 | BF | 145.0 | – |
| 3 | NF | 0.993 | – |
| 4 | VAF | 31.12 | V |
| 5 | IKF | 125.0 | mA |
| 6 | ISE | 123.6 | fA |
| 7 | NE | 3.000 | – |
| 8 | BR | 11.37 | – |
| 9 | NR | 0.985 | – |
| 10 | VAR | 1.874 | V |
| 11 | IKR | 50.00 | mA |
| 12 | ISC | 199.6 | aA |
| 13 | NC | 1.546 | – |
| 14 | RB | 35.00 | Ω |
| 15 | IRB | 0.000 | A |
| 16 | RBM | 15.00 | Ω |
| 17 | RE | 432.0 | m Ω |
| 18 | RC | 4.324 | Ω |
| 19 (1) | XTB | 1.500 | – |
| 20 (1) | EG | 1.110 | eV |
| 21 (1) | XTI | 3.000 | – |
| 22 | CJE | 128.0 | fF |
| 23 | VJE | 900.0 | mV |
| 24 | MJE | 0.346 | – |
| 25 | TF | 4.122 | ps |
| 26 | XTF | 68.20 | – |
| 27 | VTF | 2.004 | V |
| 28 | ITF | 0.627 | A |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 56.68 | fF |
| 31 | VJC | 556.9 | mV |
| 32 | MJC | 0.207 | – |
| 33 | XCJC | 0.500 | – |
| 34 (1) | TR | 0.000 | ns |
| 35 (1) | CJS | 274.8 | fF |
| 36 (1) | VJS | 418.3 | mV |
| 37 (1) | MJS | 0.239 | – |
| 38 | FC | 0.550 | – |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|----------|
| 39 (2)(3) | C_{bp} | 145 | fF |
| 40 (2) | R_{sb1} | 25 | Ω |
| 41 (3) | R_{sb2} | 19 | Ω |

Notes

- These parameters have not been extracted, the default values are shown.
- Bonding pad capacity C_{bp} in series with substrate resistance R_{sb1} between B' and E'.
- Bonding pad capacity C_{bp} in series with substrate resistance R_{sb2} between C' and E'.

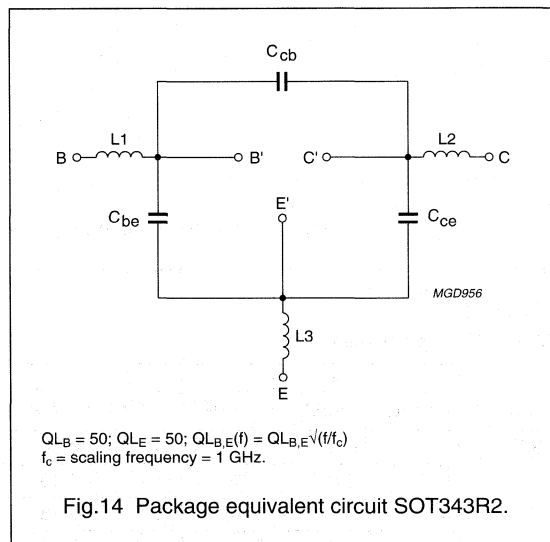


Fig.14 Package equivalent circuit SOT343R2.

List of components (see Fig.14)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 80 | fF |
| C_{cb} | 2 | fF |
| C_{ce} | 80 | fF |
| L1 | 1.1 | nH |
| L2 | 1.1 | nH |
| L3 (note 1) | 0.25 | nH |

Note

- External emitter inductance to be added separately due to the influence of the printed-circuit board.

NPN 25 GHz wideband transistor

BFG425W

FEATURES

- Very high power gain
- Low noise figure
- High transition frequency
- Emitter is thermal lead
- Low feedback capacitance.

APPLICATIONS

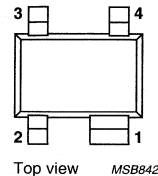
- RF front end
- Wideband applications, e.g. analog and digital cellular telephones, cordless telephones (PHS, DECT, etc.)
- Radar detectors
- Pagers
- Satellite television tuners (SATV)
- High frequency oscillators.

DESCRIPTION

NPN double polysilicon wideband transistor with buried layer for low voltage applications in a plastic, 4-pin dual-emitter SOT343R package.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



Marking code: P5.

Fig.1 Simplified outline SOT343R.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 10 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 4.5 | V |
| I_C | collector current (DC) | | – | 25 | 30 | mA |
| P_{tot} | total power dissipation | $T_s \leq 103\text{ }^\circ\text{C}$ | – | – | 135 | mW |
| h_{FE} | DC current gain | $I_C = 25\text{ mA}$; $V_{CE} = 2\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$ | 50 | 80 | 150 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 2\text{ V}$; $f = 1\text{ MHz}$ | – | 95 | – | fF |
| f_T | transition frequency | $I_C = 25\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 25 | – | GHz |
| G_{max} | maximum power gain | $I_C = 25\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 20 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}$; $V_{CE} = 2\text{ V}$; $f = 2\text{ GHz}$; $\Gamma_S = \Gamma_{opt}$ | – | 1.2 | – | dB |

CAUTION

This product is supplied in anti-static packing to prevent damage caused by electrostatic discharge during transport and handling. For further information, refer to Philips specs.: SNW-EQ-608, SNW-FQ-302A and SNW-FQ-302B.

NPN 25 GHz wideband transistor

BFG425W

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

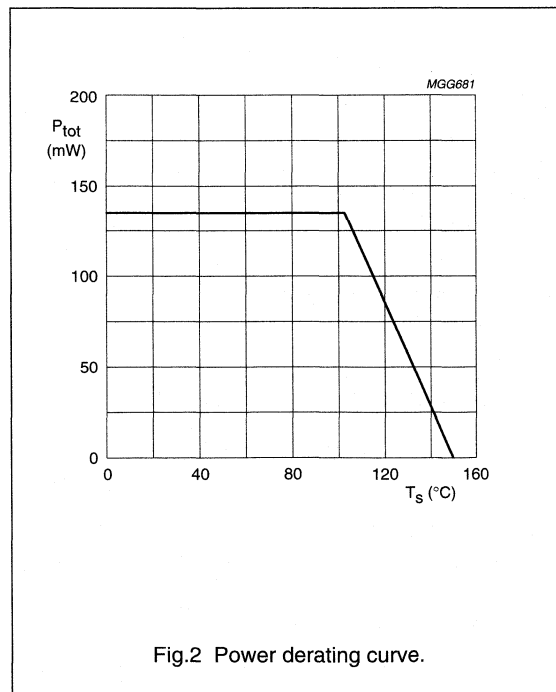
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 10 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 4.5 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 1 | V |
| I_C | collector current (DC) | | – | 30 | mA |
| P_{tot} | total power dissipation | $T_s \leq 103\text{ }^\circ\text{C}$; note 1; see Fig.2 | – | 135 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | operating junction temperature | | – | 150 | $^\circ\text{C}$ |

Note

- T_s is the temperature at the soldering point of the emitter pins.

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | 350 | K/W |



NPN 25 GHz wideband transistor

BFG425W

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

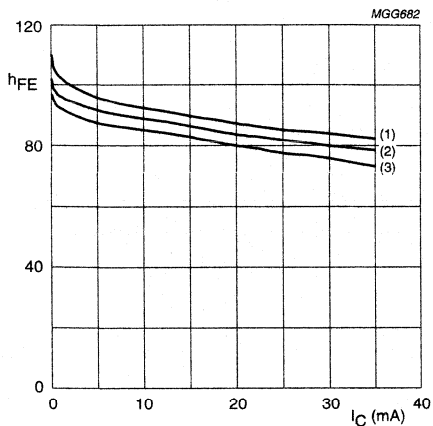
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---------------------------------------|--|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\text{ }\mu\text{A}; I_E = 0$ | 10 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 1\text{ mA}; I_B = 0$ | 4.5 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 2.5\text{ }\mu\text{A}; I_C = 0$ | 1 | – | – | V |
| I_{CBO} | collector-base leakage current | $I_E = 0; V_{CB} = 4.5\text{ V}$ | – | – | 15 | nA |
| h_{FE} | DC current gain | $I_C = 25\text{ mA}; V_{CE} = 2\text{ V}$; see Fig.3 | 50 | 80 | 150 | |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 2\text{ V}; f = 1\text{ MHz}$ | – | 300 | – | fF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 575 | – | fF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 2\text{ V}; f = 1\text{ MHz}$; see Fig.4 | – | 95 | – | fF |
| f_T | transition frequency | $I_C = 25\text{ mA}; V_{CE} = 2\text{ V}; f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see Fig.5 | – | 25 | – | GHz |
| G_{max} | maximum power gain; note 1 | $I_C = 25\text{ mA}; V_{CE} = 2\text{ V}; f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see Figs 7 and 8 | – | 20 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 25\text{ mA}; V_{CE} = 2\text{ V}; f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see Fig.8 | – | 17 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}; V_{CE} = 2\text{ V}; f = 900\text{ MHz}$; $\Gamma_S = \Gamma_{opt}$; see Fig.13 | – | 0.8 | – | dB |
| | | $I_C = 2\text{ mA}; V_{CE} = 2\text{ V}; f = 2\text{ GHz}$; $\Gamma_S = \Gamma_{opt}$; see Fig.13 | – | 1.2 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 25\text{ mA}; V_{CE} = 2\text{ V}; f = 2\text{ GHz}$; $Z_S = Z_{S\text{ opt}}; Z_L = Z_{L\text{ opt}}$; note 2 | – | 12 | – | dBm |
| ITO | third order intercept point | $I_C = 25\text{ mA}; V_{CE} = 2\text{ V}; f = 2\text{ GHz}$; $Z_S = Z_{S\text{ opt}}; Z_L = Z_{L\text{ opt}}$; note 2 | – | 22 | – | dBm |

Notes

- G_{max} is the maximum power gain, if $K > 1$. If $K < 1$ then $G_{max} = MSG$; see Figs 6; 7 and 8.
- Z_S is optimized for noise; Z_L is optimized for gain.

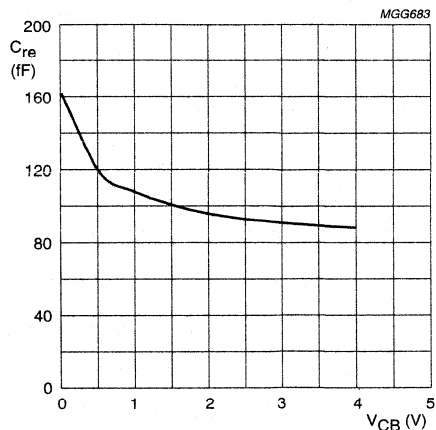
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BFG425W



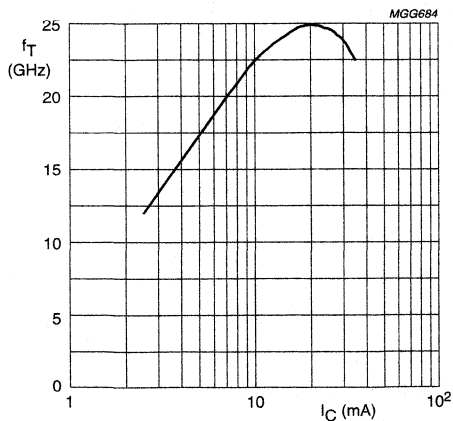
- (1) $V_{CE} = 3$ V.
- (2) $V_{CE} = 2$ V.
- (3) $V_{CE} = 1$ V.

Fig.3 DC current gain as a function of collector current; typical values.



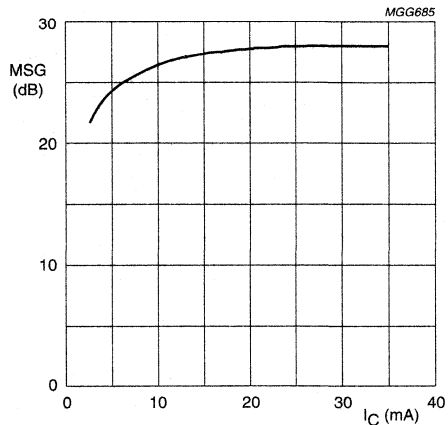
$I_C = 0$; $f = 1$ MHz.

Fig.4 Feedback capacitance as a function of collector-base voltage; typical values.



$V_{CE} = 2$ V; $f = 2$ GHz; $T_{amb} = 25$ °C.

Fig.5 Transition frequency as a function of collector current; typical values.

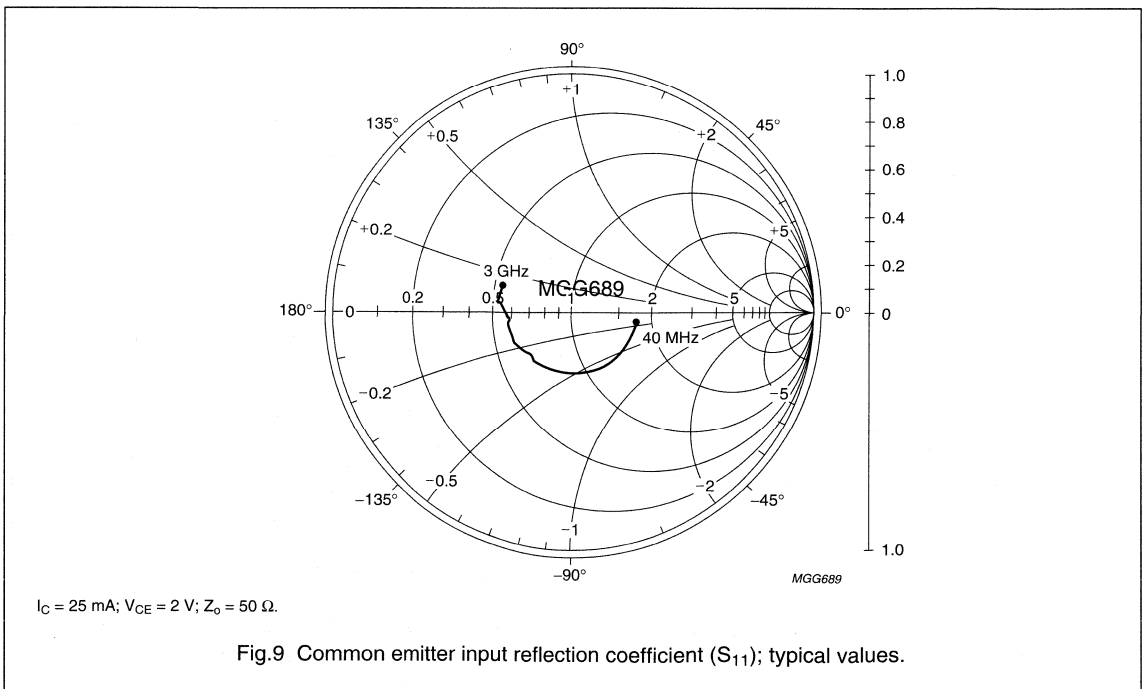
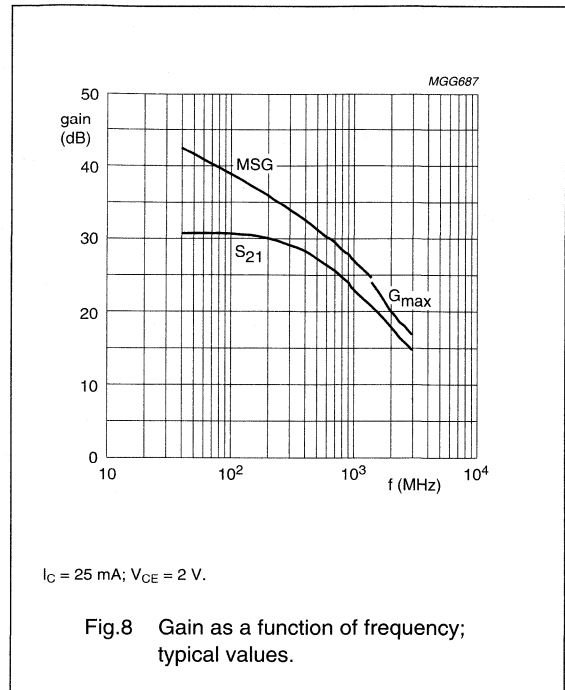
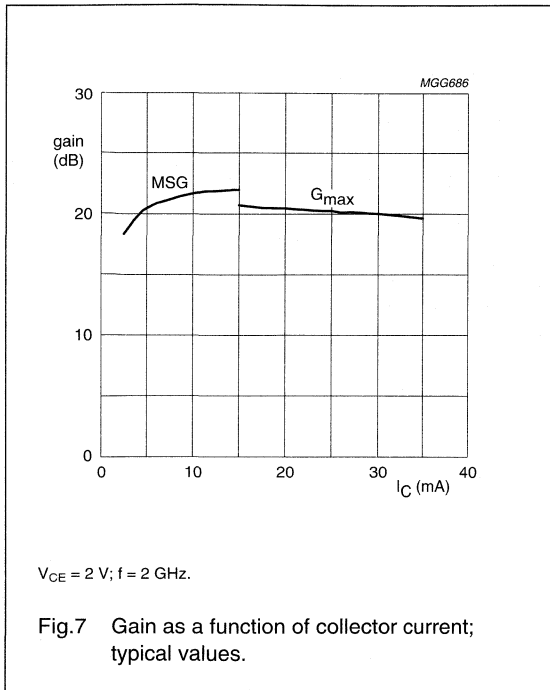


$V_{CE} = 2$ V; $f = 900$ MHz.

Fig.6 Maximum stable gain as a function of collector current; typical values.

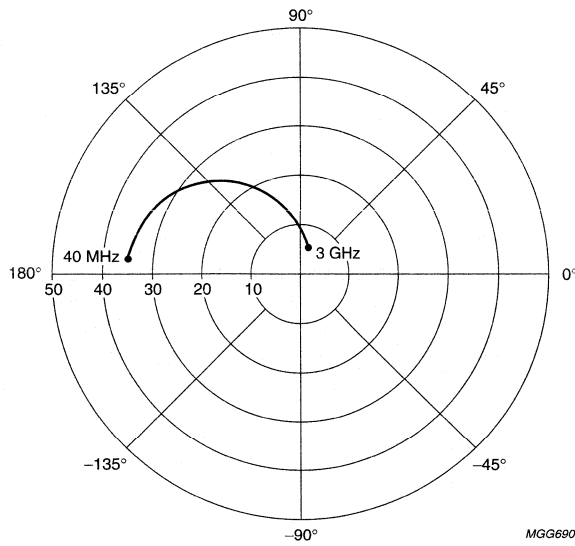
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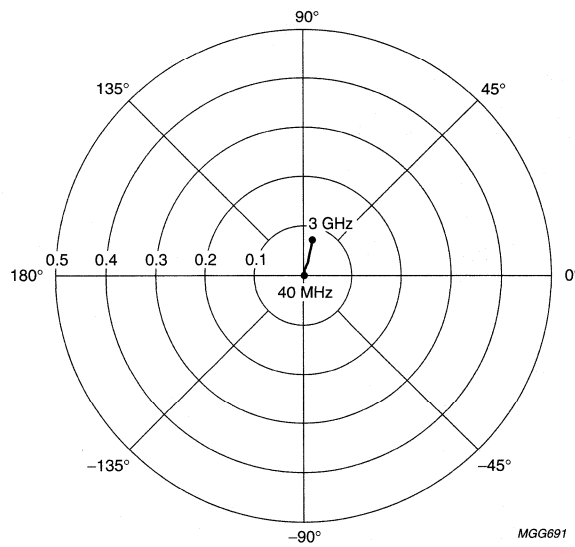
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$I_C = 25 \text{ mA}; V_{CE} = 2 \text{ V}.$

Fig.10 Common emitter forward transmission coefficient (S_{21}); typical values.

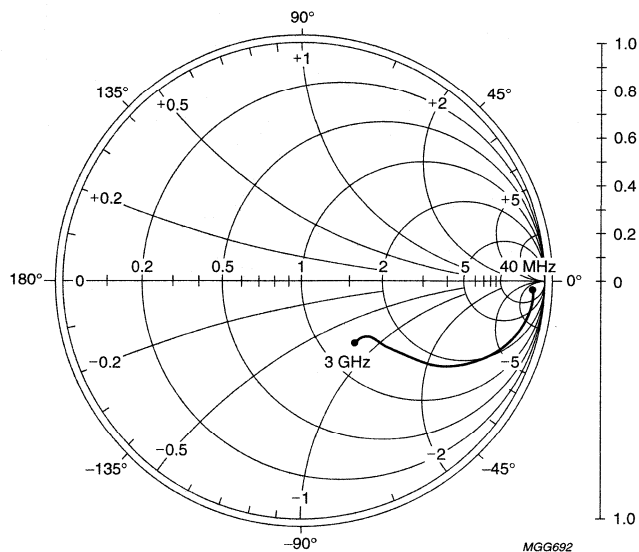


$I_C = 25 \text{ mA}; V_{CE} = 2 \text{ V}.$

Fig.11 Common emitter reverse transmission coefficient (S_{12}); typical values.

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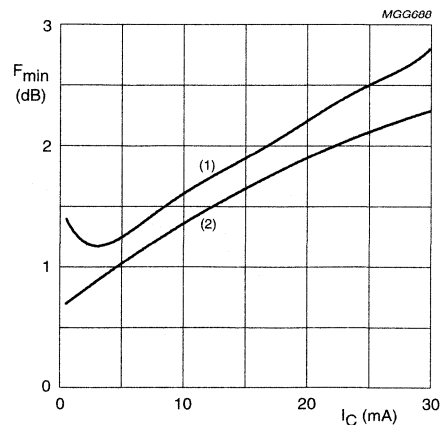
$I_C = 25 \text{ mA}$; $V_{CE} = 2 \text{ V}$; $Z_0 = 50 \Omega$.

Fig.12 Common emitter output reflection coefficient (S_{22}); typical values.

Noise data

$V_{CE} = 2 \text{ V}$; typical values.

| f (MHz) | I_C (mA) | F_{min} (dB) | Γ_{mag} | Γ_{angle} | r_n (Ω) |
|---------|------------|----------------|----------------|------------------|--------------------|
| 900 | 1 | 0.7 | 0.67 | 19.1 | 0.40 |
| | 2 | 0.8 | 0.48 | 17.8 | 0.27 |
| | 4 | 1 | 0.28 | 11.7 | 0.24 |
| | 10 | 1.4 | 0.02 | -63.9 | 0.19 |
| | 15 | 1.6 | 0.11 | -162.4 | 0.18 |
| | 20 | 1.9 | 0.19 | -165.5 | 0.18 |
| | 25 | 2.1 | 0.25 | -166.3 | 0.19 |
| 2000 | 1 | 1.3 | 0.56 | 57.5 | 0.36 |
| | 2 | 1.2 | 0.43 | 57.2 | 0.25 |
| | 4 | 1.2 | 0.22 | 60.8 | 0.18 |
| | 10 | 1.6 | 0.06 | 137.4 | 0.19 |
| | 15 | 1.9 | 0.13 | -162.1 | 0.20 |
| | 20 | 2.2 | 0.17 | -155.5 | 0.20 |
| | 25 | 2.5 | 0.22 | -152.2 | 0.21 |
| 30 | 2.8 | 0.27 | -150.8 | 0.25 | |



(1) $V_{CE} = 2 \text{ V}$; $f = 2 \text{ GHz}$.
 (2) $V_{CE} = 2 \text{ V}$; $f = 900 \text{ MHz}$.

Fig.13 Minimum noise figure as a function of the collector current; typical values.

NPN 25 GHz wideband transistor

BFG425W

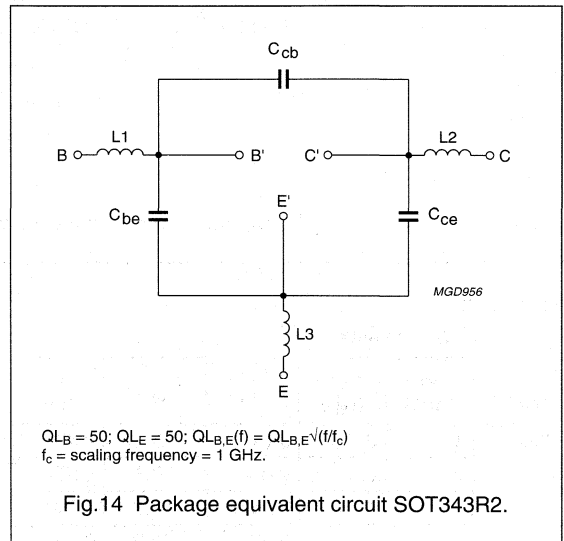
SPICE parameters for the BFG425W die

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|------------|
| 1 | IS | 47.17 | aA |
| 2 | BF | 145.0 | — |
| 3 | NF | 0.993 | — |
| 4 | VAF | 31.12 | V |
| 5 | IKF | 304.0 | mA |
| 6 | ISE | 300.2 | fA |
| 7 | NE | 3.000 | — |
| 8 | BR | 11.37 | — |
| 9 | NR | 0.985 | — |
| 10 | VAR | 1.874 | V |
| 11 | IKR | 0.121 | A |
| 12 | ISC | 484.8 | aA |
| 13 | NC | 1.546 | — |
| 14 | RB | 14.41 | Ω |
| 15 | IRB | 0.000 | A |
| 16 | RBM | 6.175 | Ω |
| 17 | RE | 177.9 | m Ω |
| 18 | RC | 1.780 | Ω |
| 19 (1) | XTB | 1.500 | — |
| 20 (1) | EG | 1.110 | eV |
| 21 (1) | XTI | 3.000 | — |
| 22 | CJE | 310.9 | fF |
| 23 | VJE | 900.0 | mV |
| 24 | MJE | 0.346 | — |
| 25 | TF | 4.122 | ps |
| 26 | XTF | 68.20 | — |
| 27 | VTF | 2.004 | V |
| 28 | ITF | 1.525 | A |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 137.7 | fF |
| 31 | VJC | 556.9 | mV |
| 32 | MJC | 0.207 | — |
| 33 | XCJC | 0.500 | — |
| 34 (1) | TR | 0.000 | ns |
| 35 (1) | CJS | 667.5 | fF |
| 36 (1) | VJS | 418.3 | mV |
| 37 (1) | MJS | 0.239 | — |
| 38 | FC | 0.550 | — |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|----------|
| 39 (2)(3) | C_{bp} | 145 | fF |
| 40 (2) | R_{sb1} | 25 | Ω |
| 41 (3) | R_{sb2} | 19 | Ω |

Notes

1. These parameters have not been extracted, the default values are shown.
2. Bonding pad capacity C_{bp} in series with substrate resistance R_{sb1} between B' and E'.
3. Bonding pad capacity C_{bp} in series with substrate resistance R_{sb2} between C' and E'.



List of components (see Fig.14)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 80 | fF |
| C_{cb} | 2 | fF |
| C_{ce} | 80 | fF |
| L1 | 1.1 | nH |
| L2 | 1.1 | nH |
| L3 (note 1) | 0.25 | nH |

Note

1. External emitter inductance to be added separately due to the influence of the printed-circuit board.

NPN 9 GHz wideband transistor

BFG505; BFG505/X; BFG505/XR

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

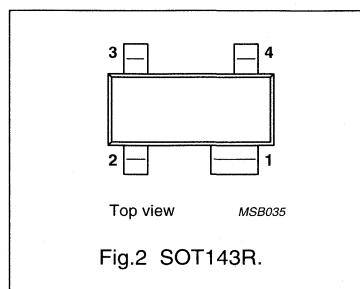
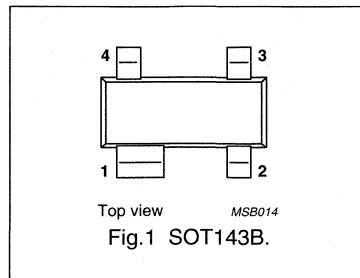
DESCRIPTION

The BFG505 is an NPN silicon planar epitaxial transistor, intended for applications in the RF frontend in the GHz range, such as analog and digital cellular telephones, cordless telephones (CT1, CT2, DECT, etc.), radar detectors, pagers and satellite TV tuners (SATV).

The transistors are mounted in a plastic SOT143 envelope.

PINNING

| PIN | DESCRIPTION |
|-----------------------------|-------------|
| BFG505 (Fig.1) Code: N33 | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG505/X (Fig.1) Code: N39 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG505/XR (Fig.2) Code: N45 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_c | DC collector current | | – | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 130\text{ }^\circ\text{C}$; note 1 | – | – | 150 | mW |
| h_{FE} | DC current gain | $V_{CE} = 6\text{ V}$; $I_c = 5\text{ mA}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $V_{CB} = 6\text{ V}$; $I_c = i_c = 0$; $f = 1\text{ MHz}$ | – | 0.2 | – | pF |
| f_T | transition frequency | $V_{CE} = 6\text{ V}$; $I_c = 5\text{ mA}$; $f = 1\text{ GHz}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $V_{CE} = 6\text{ V}$; $I_c = 5\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 20 | – | dB |
| | | $V_{CE} = 6\text{ V}$; $I_c = 5\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 13 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $V_{CE} = 6\text{ V}$; $I_c = 5\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | 16 | 17 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $V_{CE} = 6\text{ V}$; $I_c = 1.25\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 1.2 | 1.7 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $V_{CE} = 6\text{ V}$; $I_c = 5\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $V_{CE} = 6\text{ V}$; $I_c = 1.25\text{ mA}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 1.9 | – | dB |

NPN 9 GHz wideband transistor

BFG505; BFG505/X; BFG505/XR

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 130$ °C; note 1 | – | 150 | mW |
| T_{stg} | storage temperature range | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 290 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFG505; BFG505/X; BFG505/XR

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $V_{CB} = 6\text{ V}; I_E = 0;$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $V_{CE} = 6\text{ V}; I_C = 5\text{ mA};$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $V_{EB} = 0.5\text{ V}; I_C = I_e = 0; f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| C_c | collector capacitance | $V_{CB} = 6\text{ V}; I_E = I_e = 0; f = 1\text{ MHz}$ | – | 0.3 | – | pF |
| C_{re} | feedback capacitance | $V_{CB} = 6\text{ V}; I_C = 0; f = 1\text{ MHz}$ | – | 0.2 | – | pF |
| f_T | transition frequency | $V_{CE} = 6\text{ V}; I_C = 5\text{ mA}; f = 1\text{ GHz}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $V_{CE} = 6\text{ V}; I_C = 5\text{ mA};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 20 | – | dB |
| | | $V_{CE} = 6\text{ V}; I_C = 5\text{ mA};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 2\text{ GHz}$ | – | 13 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $V_{CE} = 6\text{ V}; I_C = 5\text{ mA};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | 16 | 17 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}; V_{CE} = 6\text{ V}; I_C = 1.25\text{ mA};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 1.2 | 1.7 | dB |
| | | $\Gamma_s = \Gamma_{opt}; V_{CE} = 6\text{ V}; I_C = 5\text{ mA};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}; V_{CE} = 6\text{ V}; I_C = 1.25\text{ mA};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 2\text{ GHz}$ | – | 1.9 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $V_{CE} = 6\text{ V}; I_C = 5\text{ mA}; R_L = 50\text{ } \Omega;$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 4 | – | dBm |
| ITO | third order intercept point | note 2 | – | 10 | – | dBm |

Notes

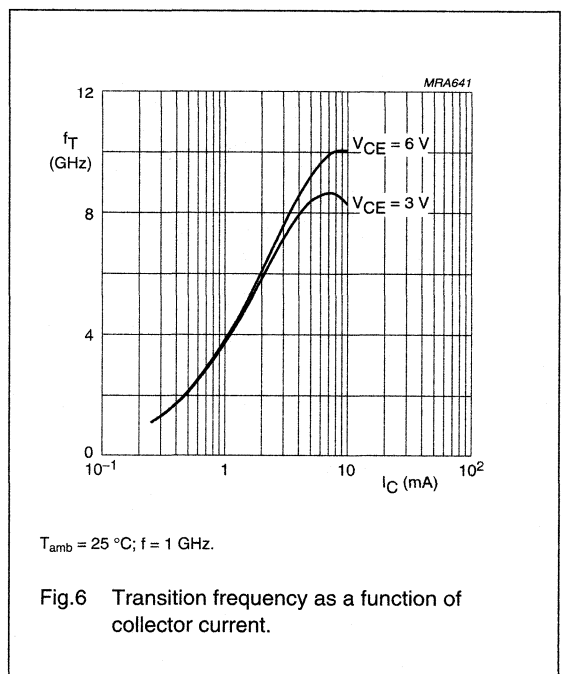
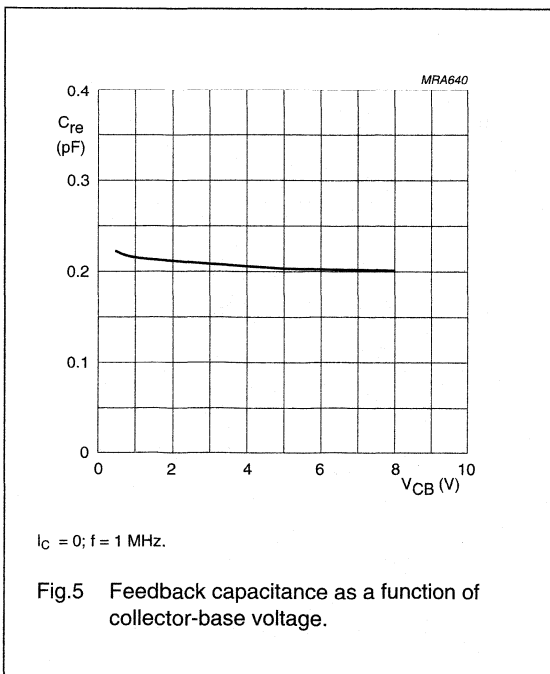
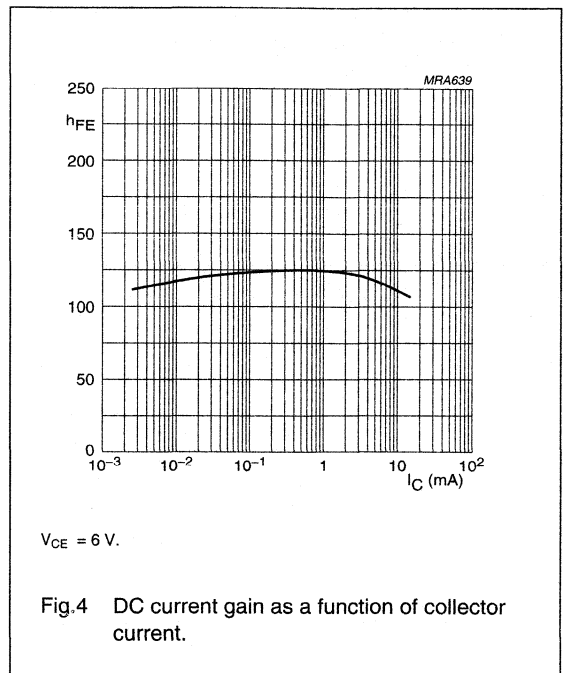
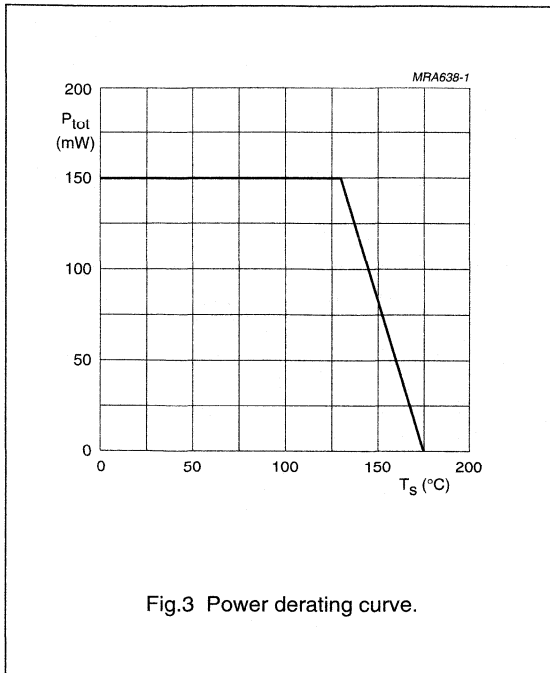
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{dB.}$$

2. $V_{CE} = 6\text{ V}; I_C = 5\text{ mA}; R_L = 50\text{ } \Omega; T_{amb} = 25\text{ }^\circ\text{C};$
 $f_p = 900\text{ MHz}; f_q = 902\text{ MHz};$
 measured at $f_{(2p-q)} = 898\text{ MHz}$ and $f_{(2q-p)} = 904\text{ MHz}.$

NPN 9 GHz wideband transistor

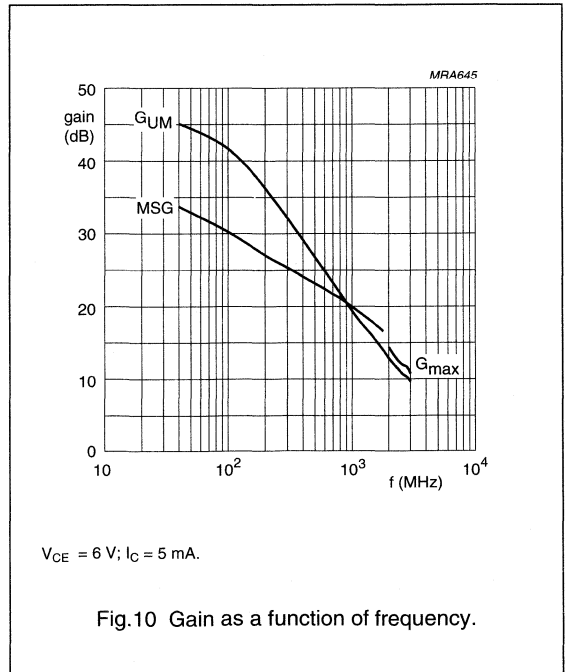
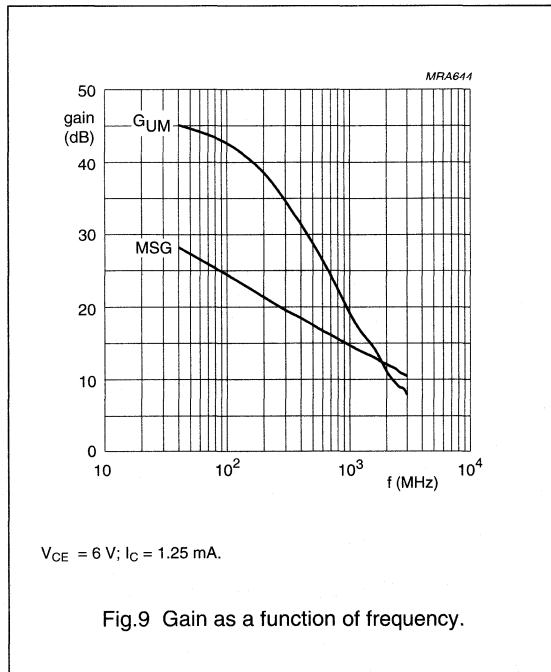
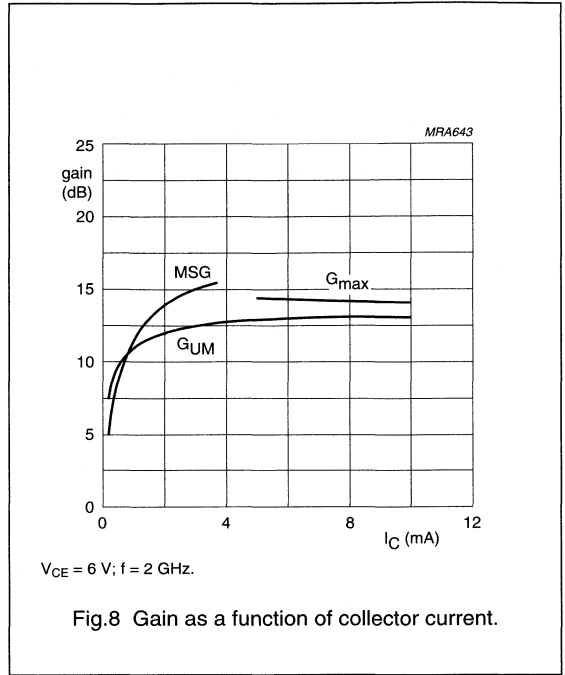
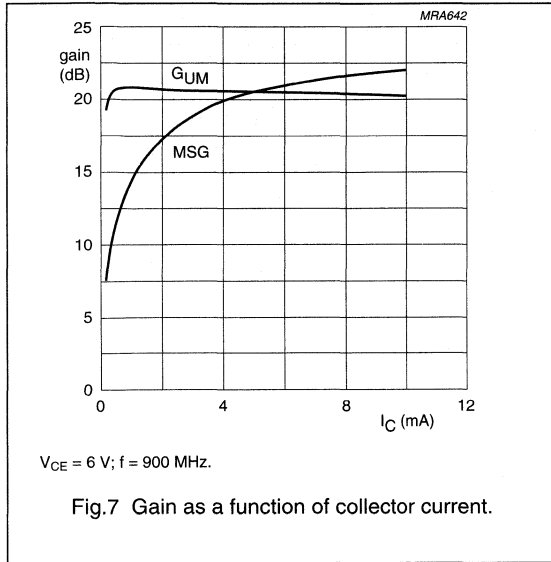
BFG505; BFG505/X; BFG505/XR



NPN 9 GHz wideband transistor

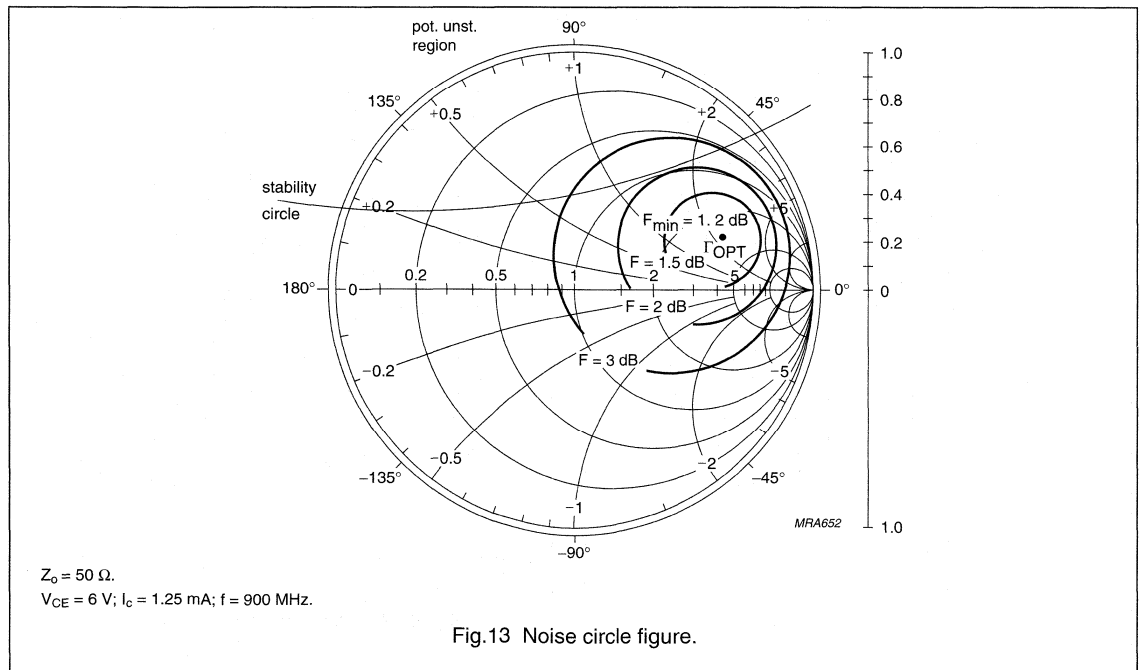
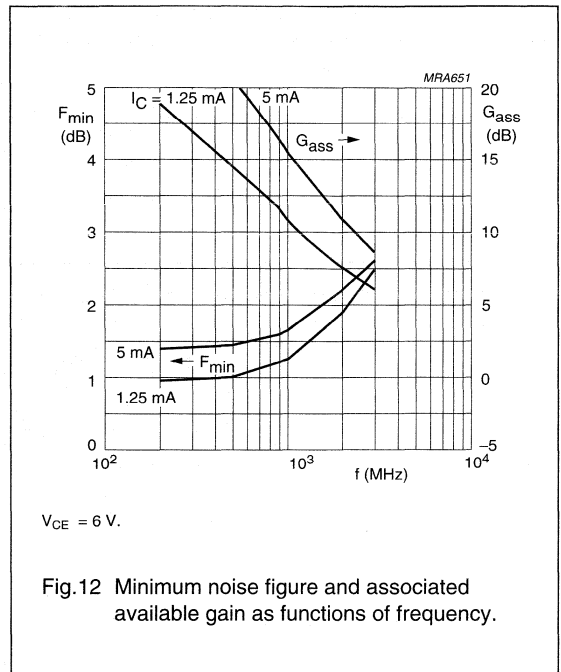
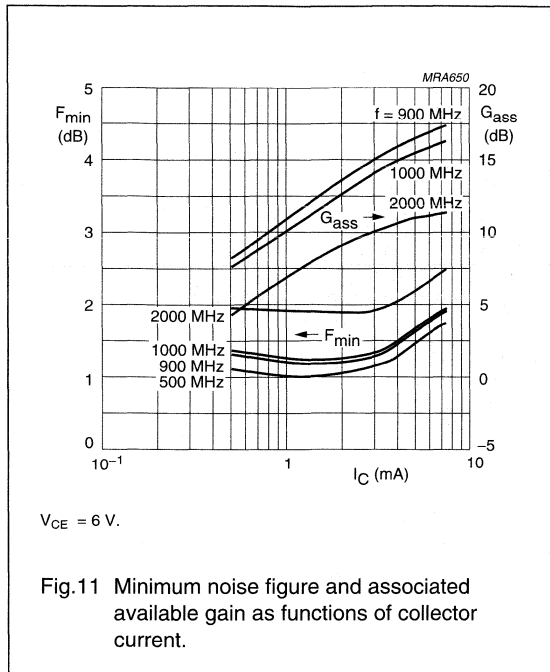
BFG505; BFG505/X; BFG505/XR

In Figs 7 to 10, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



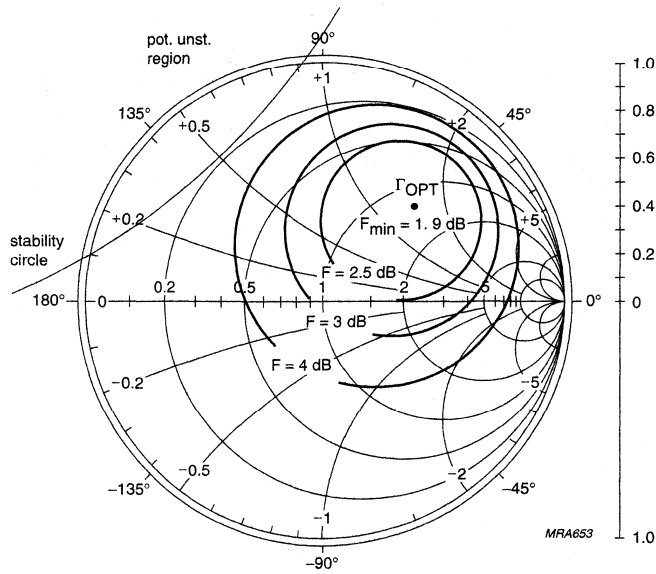
NPN 9 GHz wideband transistor

BFG505; BFG505/X; BFG505/XR



NPN 9 GHz wideband transistor

BFG505; BFG505/X; BFG505/XR

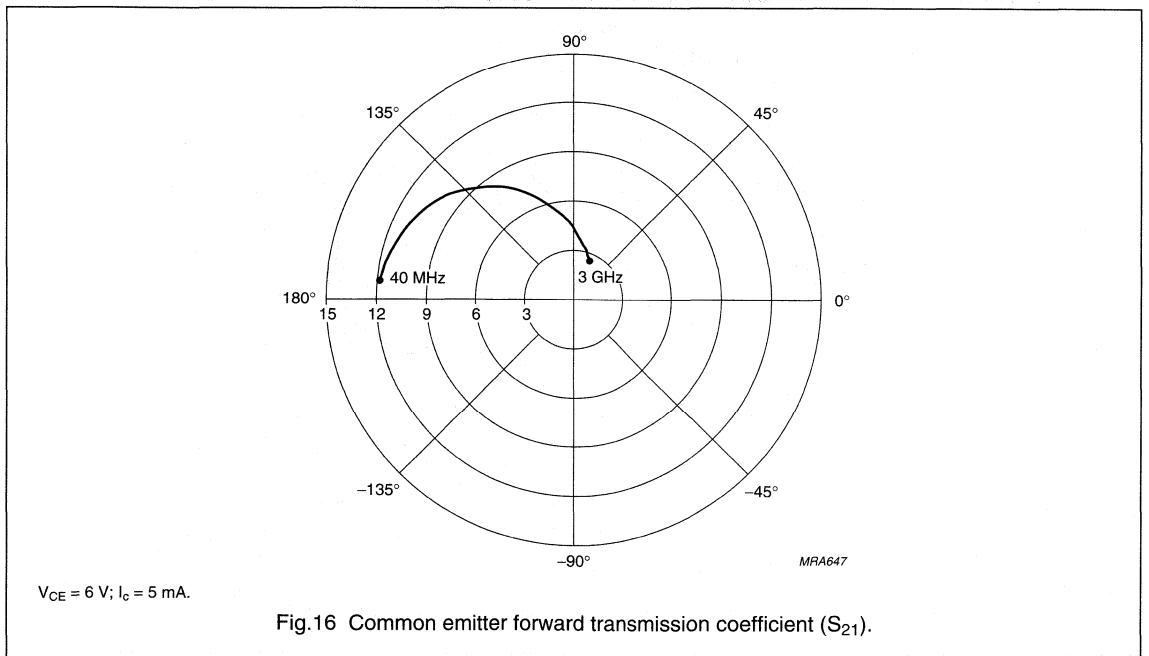
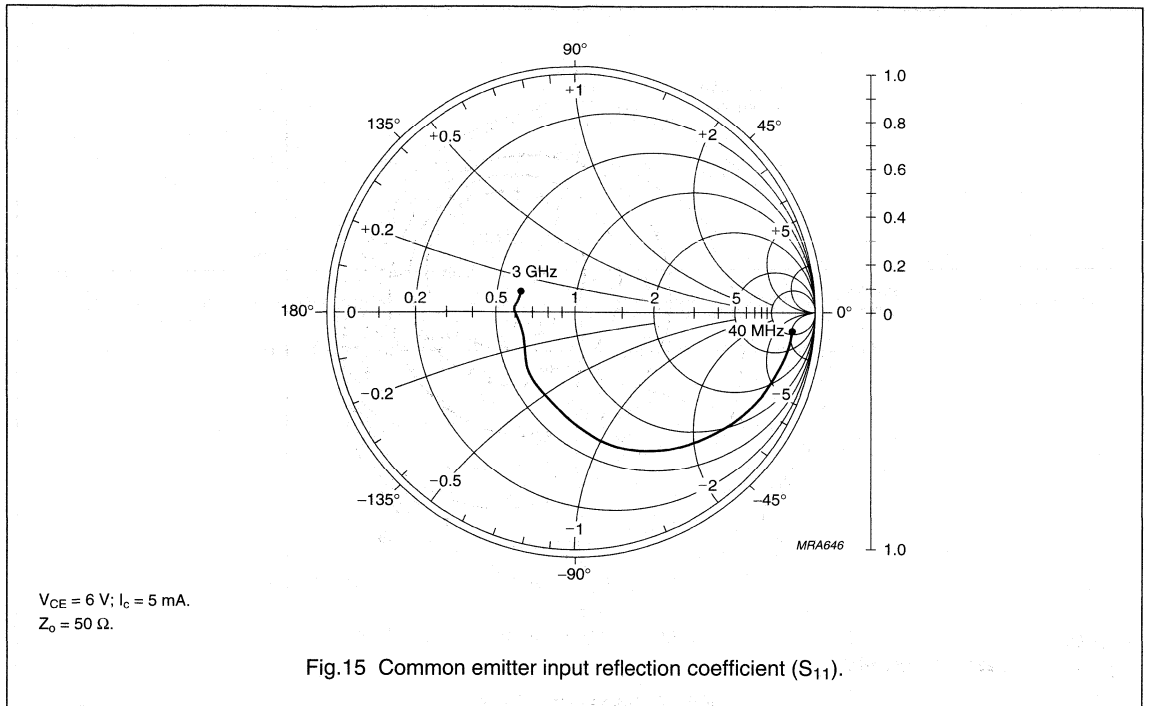


$Z_0 = 50 \Omega$.
 $V_{CE} = 6 \text{ V}$; $I_C = 1.25 \text{ mA}$; $f = 2000 \text{ MHz}$.

Fig.14 Noise circle figure.

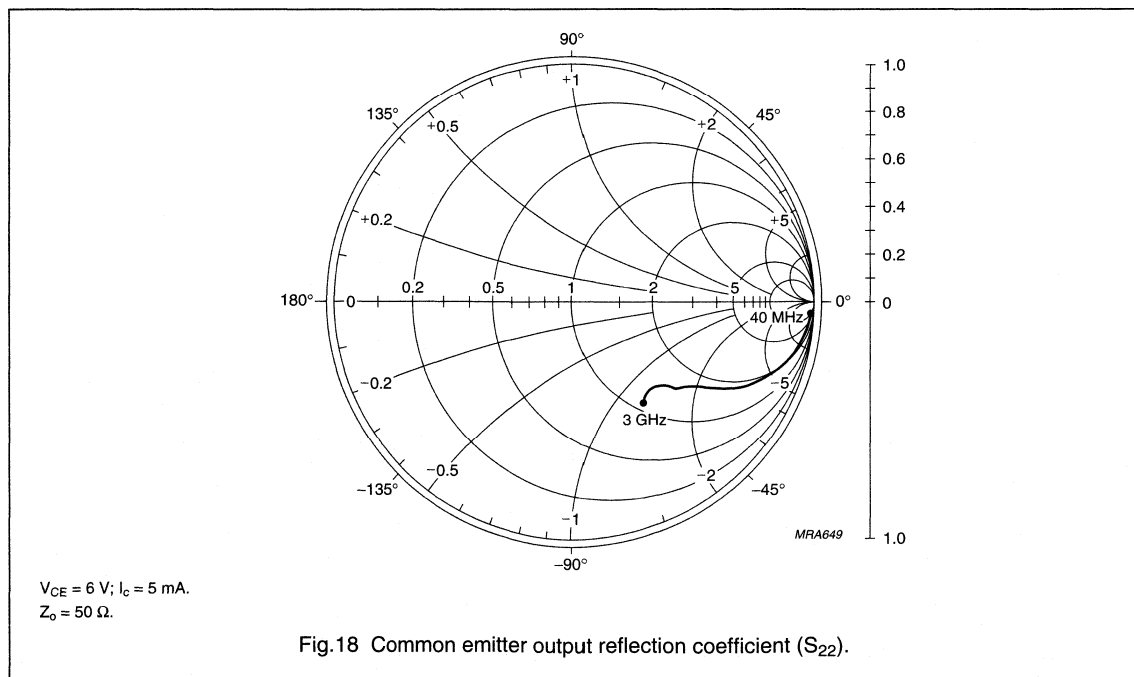
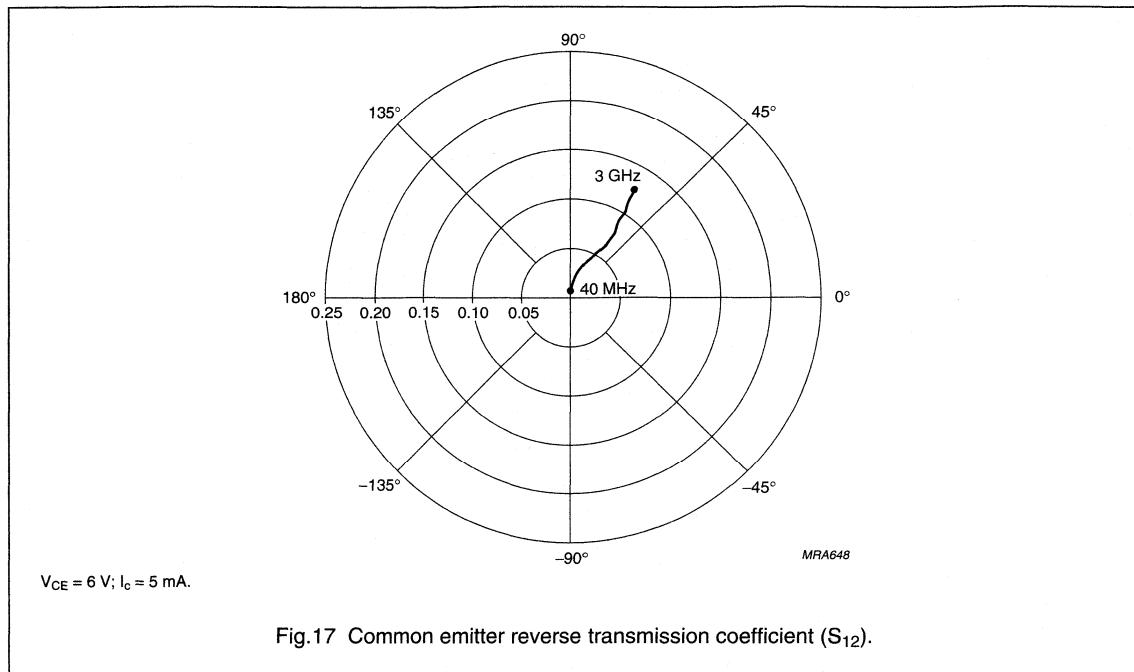
NPN 9 GHz wideband transistor

BFG505; BFG505/X; BFG505/XR



NPN 9 GHz wideband transistor

BFG505; BFG505/X; BFG505/XR



NPN 9 GHz wideband transistor

BFG505W
BFG505W/X; BFG505W/XR

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

APPLICATIONS

They are intended for applications in the RF front end, in wideband applications in the GHz range such as analog and digital cellular telephones, cordless telephones (CT2, CT3, PCN, DECT, etc.), radar detectors, pagers, satellite television tuners (SATV).

DESCRIPTION

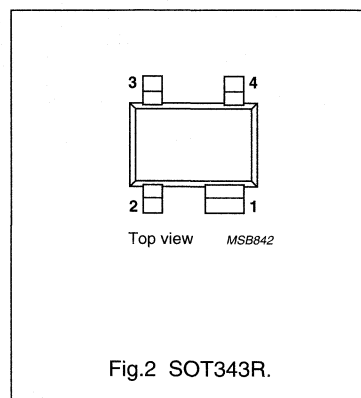
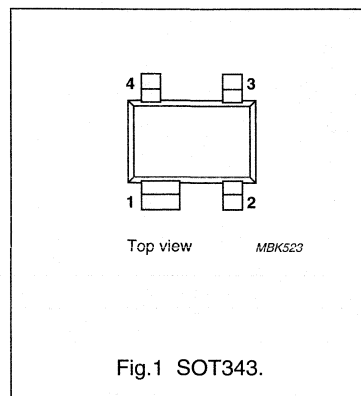
NPN silicon planar epitaxial transistors in plastic, 4-pin dual-emitter SOT343 and SOT343R packages.

MARKING

| TYPE NUMBER | CODE |
|-------------|------|
| BFG505W | N0 |
| BFG505W/X | N1 |
| BFG505W/XR | P0 |

PINNING

| PIN | DESCRIPTION |
|-------------------------------|-------------|
| BFG505W (see Fig.1) | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG505W/X (see Fig.1) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG505W/XR (see Fig.2) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | collector current (DC) | | – | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85^\circ\text{C}$ | – | – | 500 | mW |
| h_{FE} | DC current gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.2 | – | pF |
| f_T | transition frequency | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25^\circ\text{C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25^\circ\text{C}$ | – | 19 | – | dB |
| | | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25^\circ\text{C}$ | – | 12 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25^\circ\text{C}$ | 15 | 16 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 1.25\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 2\text{ GHz}$ | – | 1.9 | – | dB |

NPN 9 GHz wideband transistor

BFG505W
BFG505W/X; BFG505W/XR

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ °C}$; see Fig.3; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|-------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 85\text{ °C}$; note 1 | 180 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.

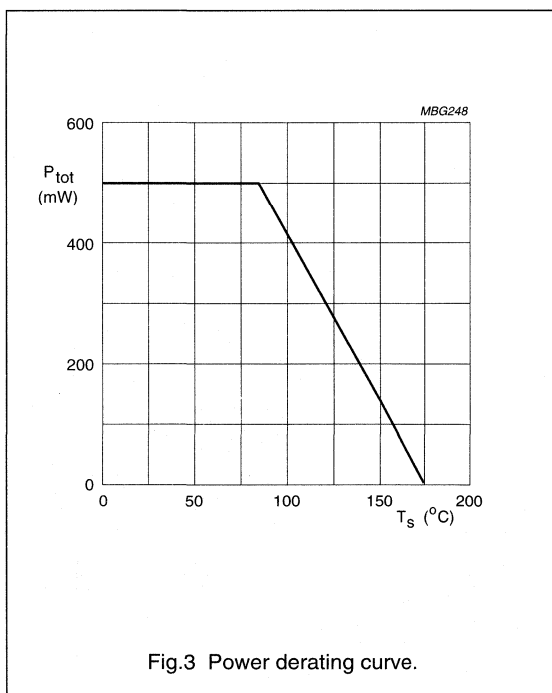


Fig.3 Power derating curve.

NPN 9 GHz wideband transistor

BFG505W
BFG505W/X; BFG505W/XR

CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ (unless otherwise specified).

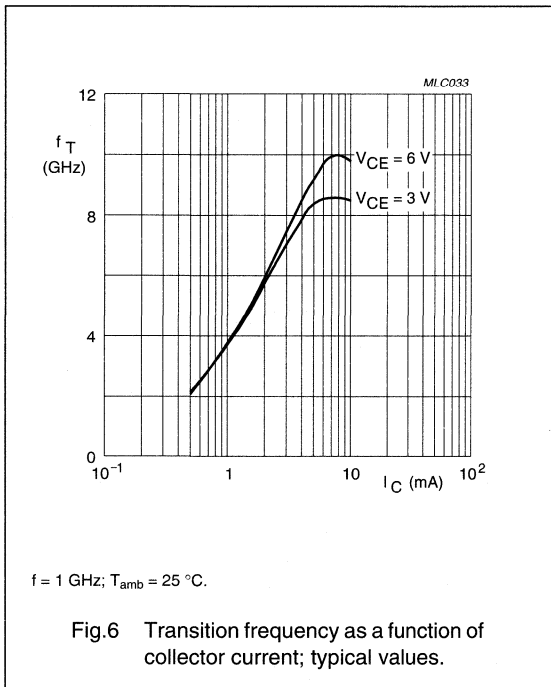
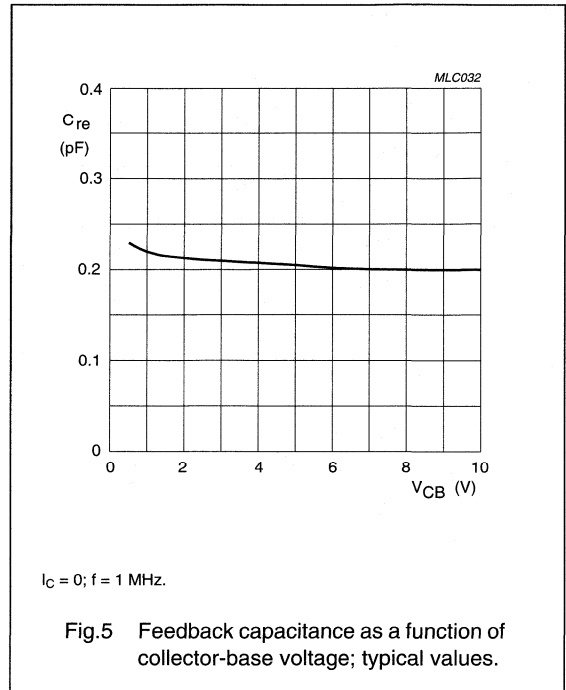
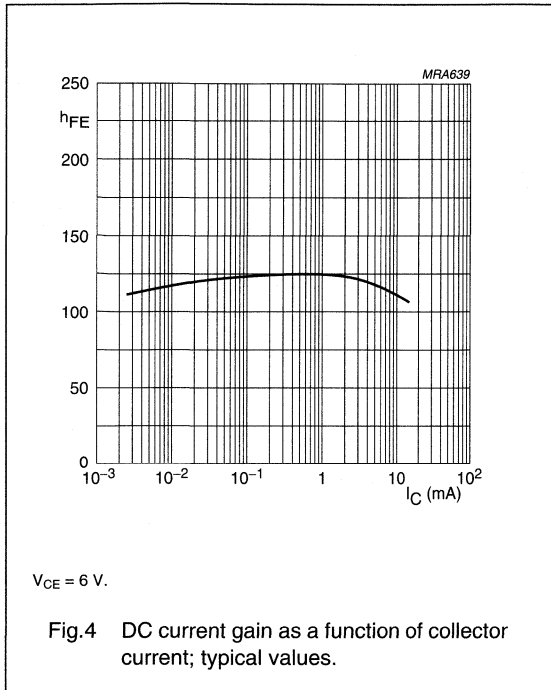
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---------------------------------------|---|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 2.5\text{ }\mu\text{A}$; $I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CES}$ | collector-emitter breakdown voltage | $R_{BE} = 0$; $I_C = 10\text{ }\mu\text{A}$ | 15 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 2.5\text{ }\mu\text{A}$; $I_C = 0$ | 2.5 | – | – | V |
| I_{CBO} | collector cut-off current | open emitter; $V_{CB} = 6\text{ V}$; $I_E = 0$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| f_T | transition frequency | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 9 | – | GHz |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.3 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.2 | – | pF |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 19 | – | dB |
| | | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 12 | – | dB |
| $ s_{21} ^2$ | insertion power gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 15 | 16 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 1.25\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$ | – | 1.2 | 1.7 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 1.25\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 2\text{ GHz}$ | – | 1.9 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $R_L = 50\text{ }\Omega$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 4 | – | dBm |
| ITO | third order intercept point | note 2 | – | 10 | – | dBm |

Notes

- G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.
- $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $R_L = 50\text{ }\Omega$; $T_{amb} = 25\text{ }^\circ\text{C}$;
 $f_p = 900\text{ MHz}$; $f_q = 902\text{ MHz}$; measured at $f_{(2p-q)} = 904\text{ MHz}$.

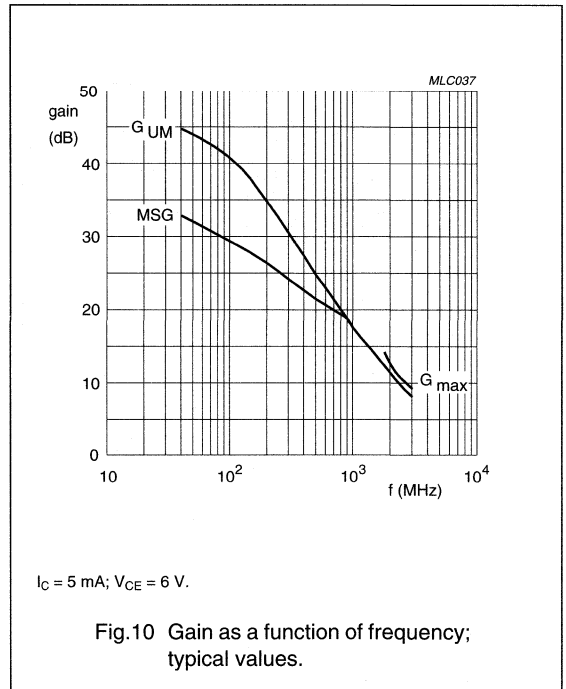
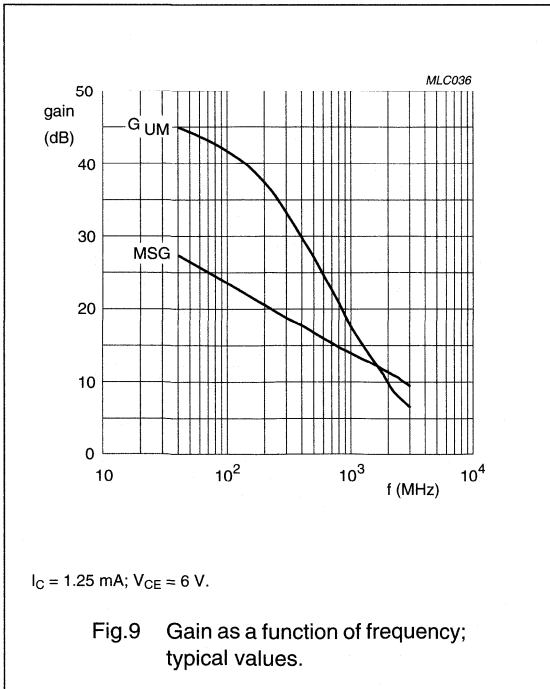
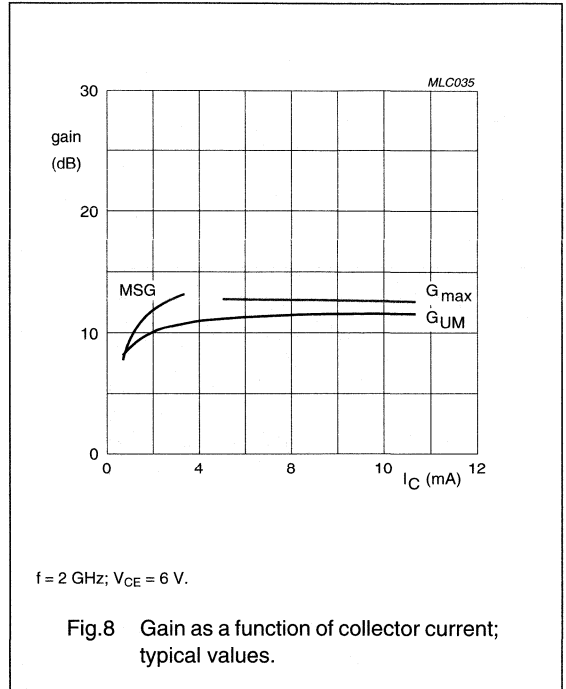
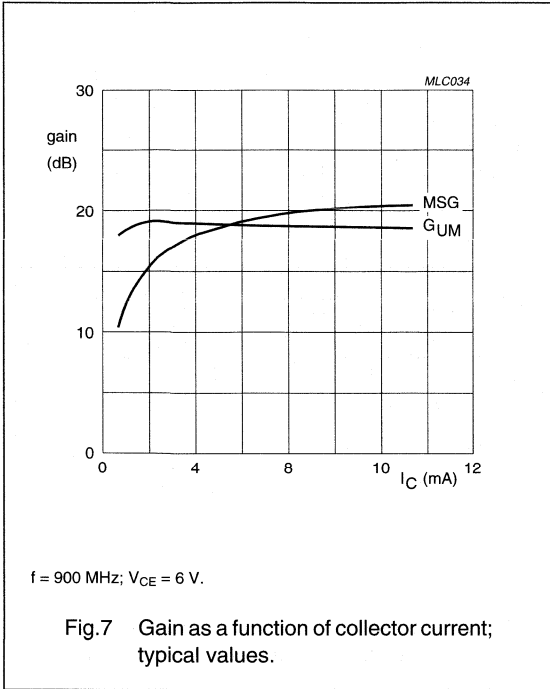
NPN 9 GHz wideband transistor

BFG505W
BFG505W/X; BFG505W/XR



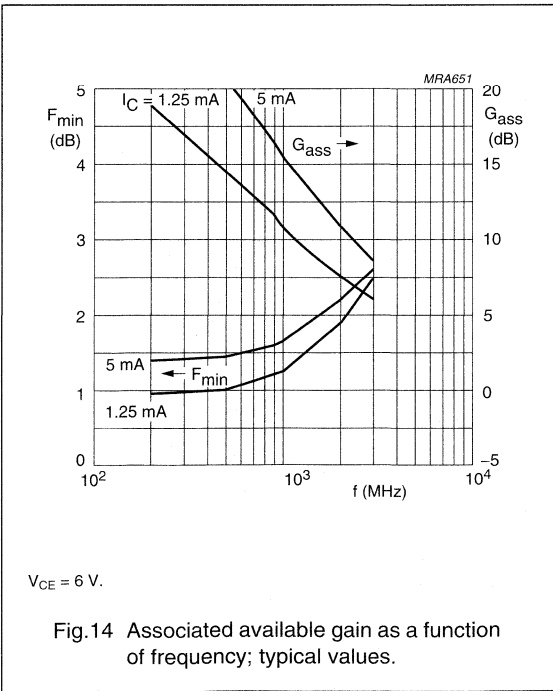
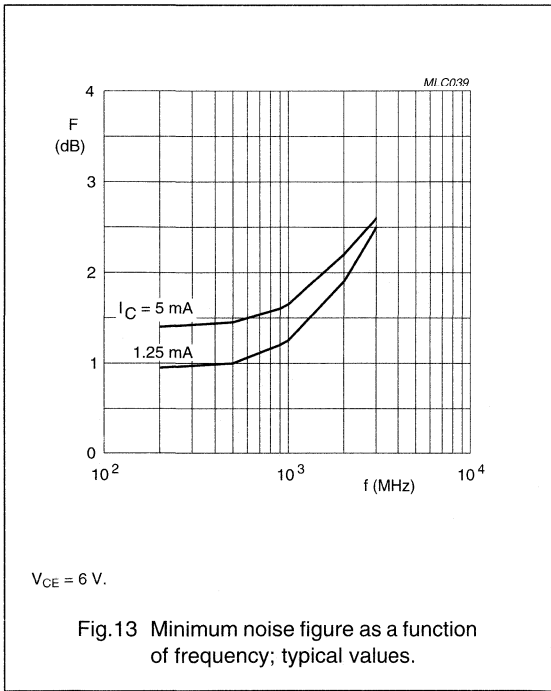
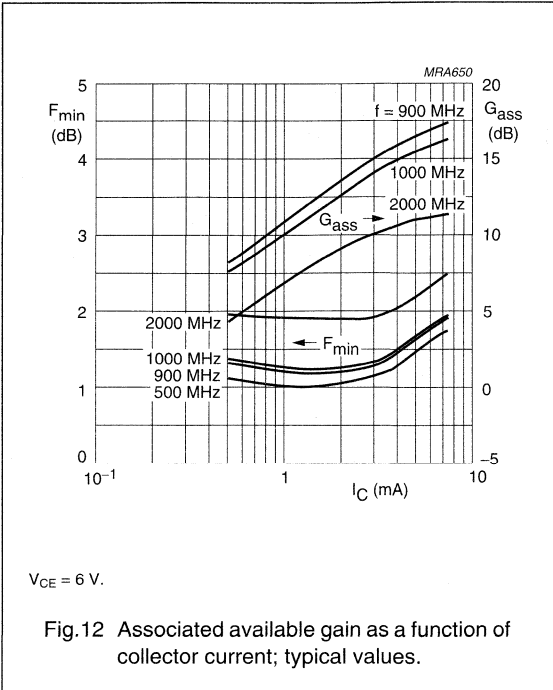
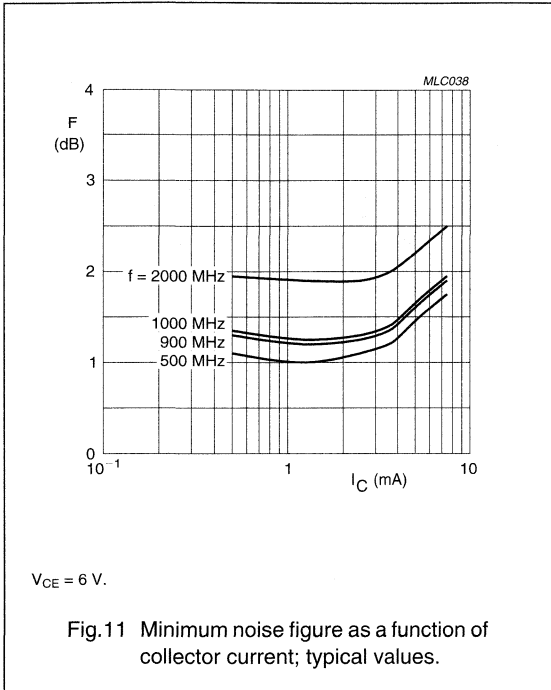
NPN 9 GHz wideband transistor

BFG505W
BFG505W/X; BFG505W/XR



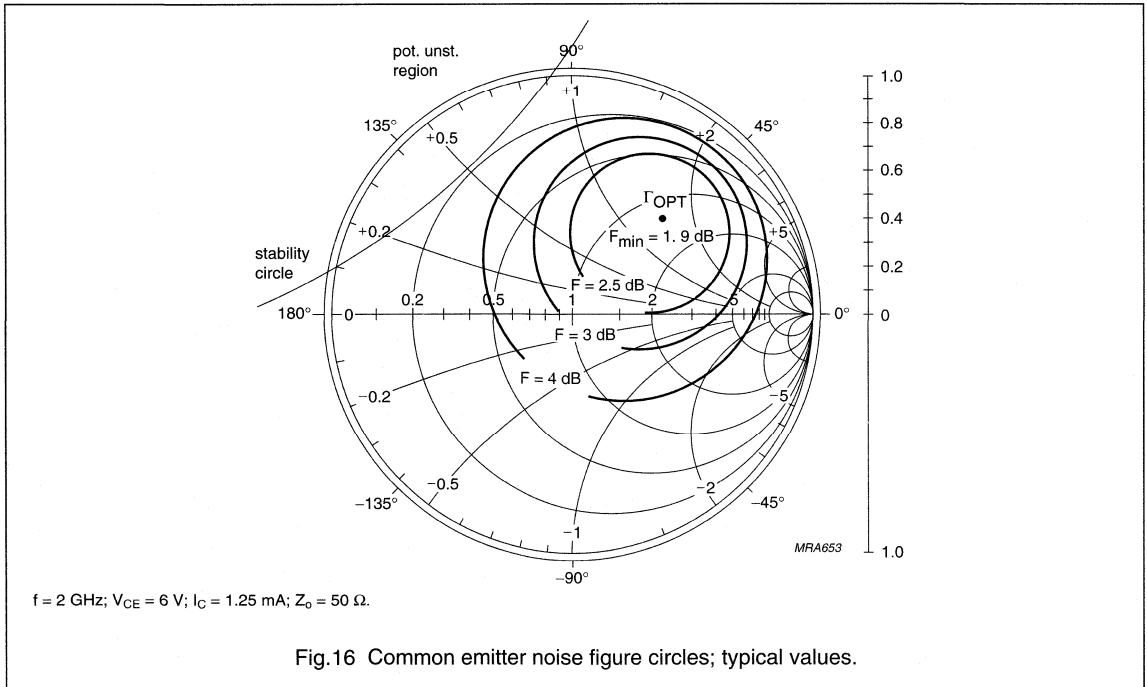
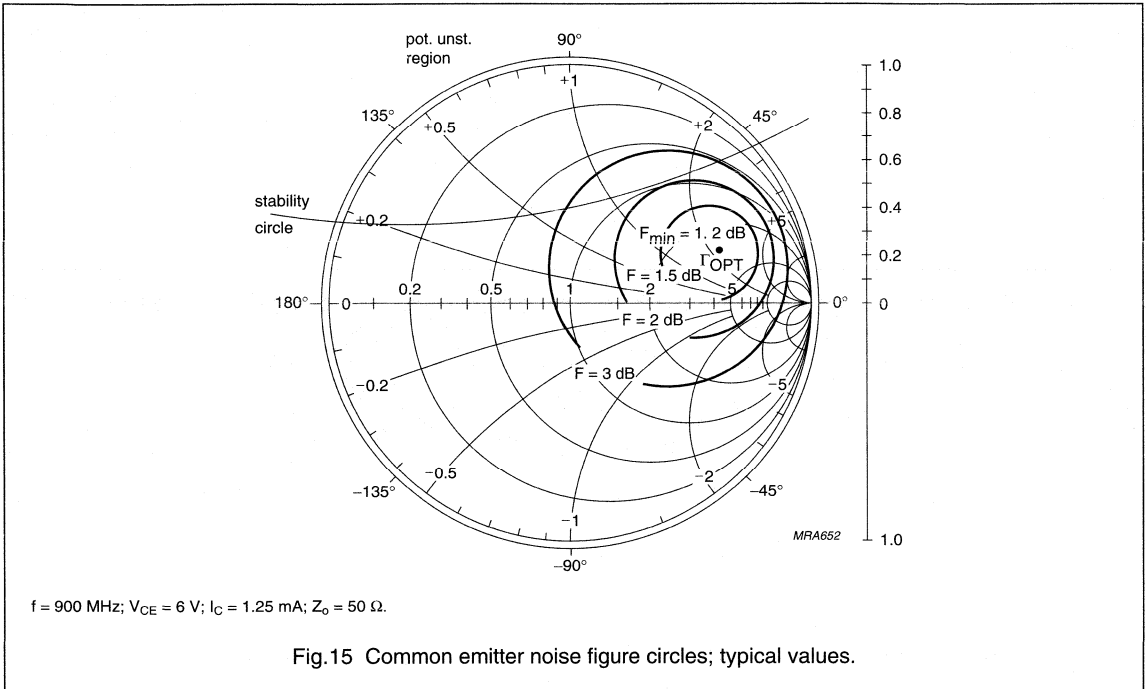
NPN 9 GHz wideband transistor

BFG505W
BFG505W/X; BFG505W/XR



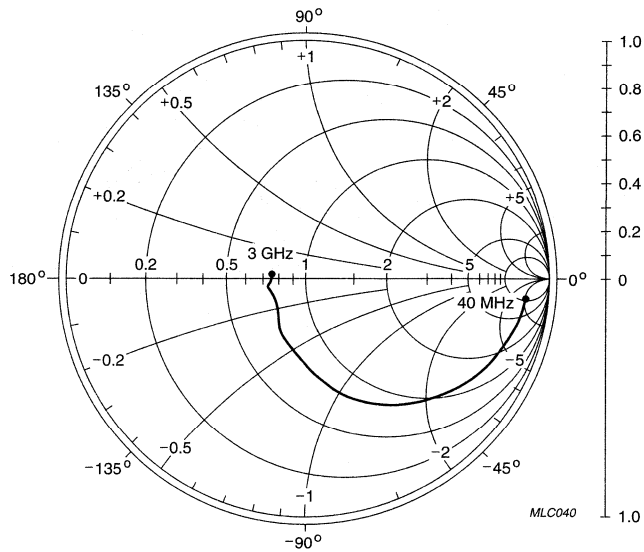
NPN 9 GHz wideband transistor

BFG505W
BFG505W/X; BFG505W/XR



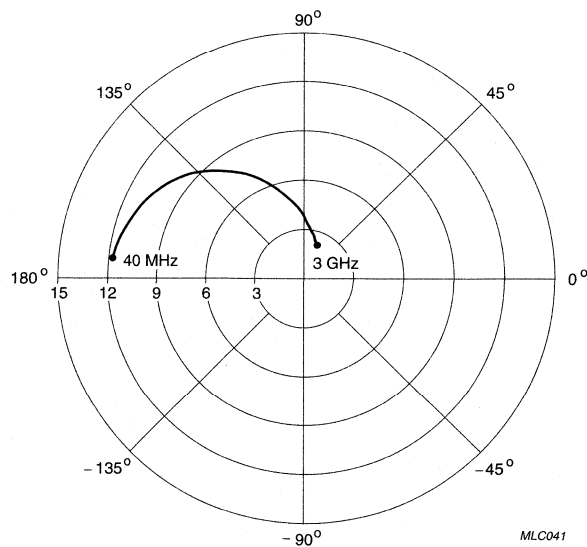
NPN 9 GHz wideband transistor

BFG505W
BFG505W/X; BFG505W/XR



$V_{CE} = 6\text{ V}; I_C = 5\text{ mA}; Z_0 = 50\ \Omega.$

Fig.17 Common emitter input reflection coefficient (s_{11}); typical values.

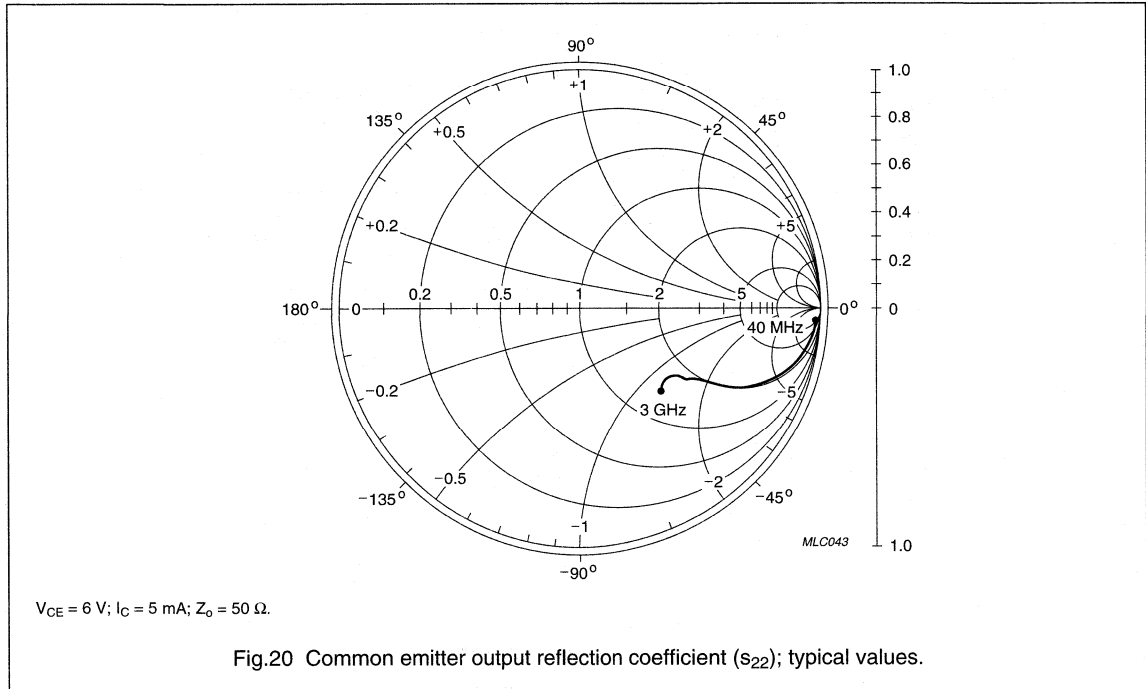
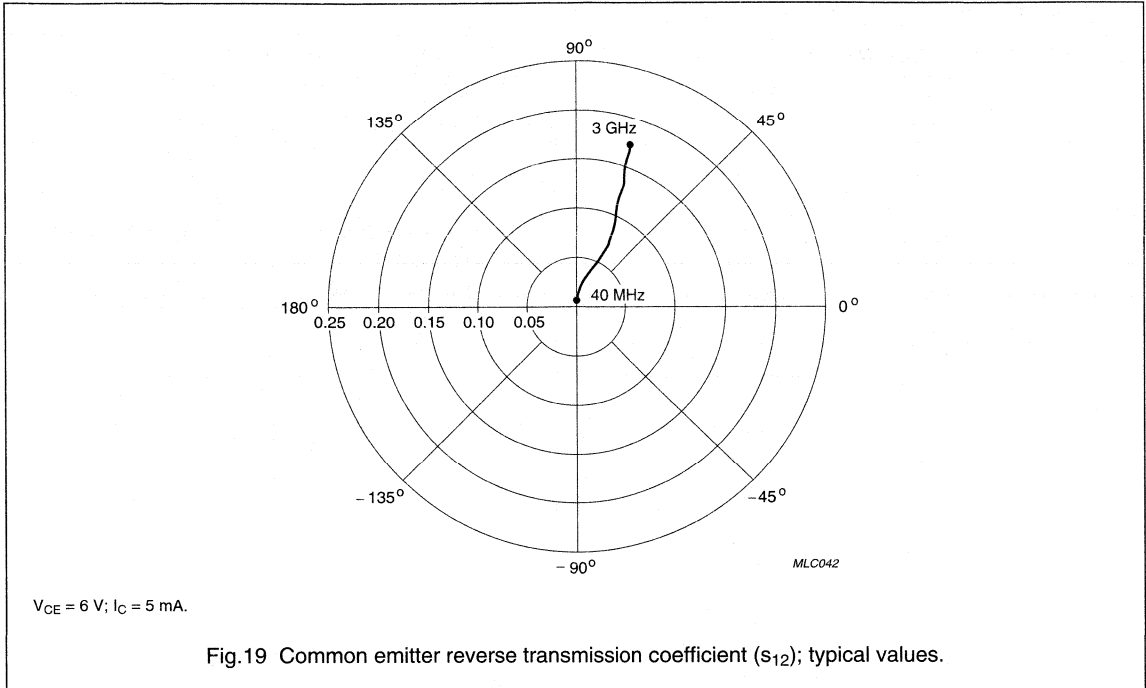


$V_{CE} = 6\text{ V}; I_C = 5\text{ mA}.$

Fig.18 Common emitter forward transmission coefficient (s_{21}); typical values.

NPN 9 GHz wideband transistor

BFG505W
BFG505W/X; BFG505W/XR



NPN 9 GHz wideband transistor

BFG505W BFG505W/X; BFG505W/XR

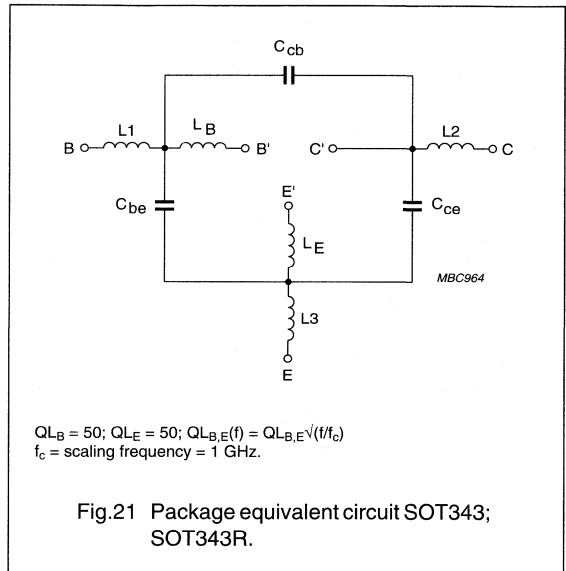
SPICE parameters for the BFG505W crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 1 | IS | 134.1 | aA |
| 2 | BF | 180.0 | – |
| 3 | NF | 0.988 | – |
| 4 | VAF | 38.34 | V |
| 5 | IKF | 150.0 | mA |
| 6 | ISE | 27.81 | fA |
| 7 | NE | 2.051 | – |
| 8 | BR | 55.19 | – |
| 9 | NR | 0.982 | – |
| 10 | VAR | 2.459 | V |
| 11 | IKR | 2.920 | mA |
| 12 | ISC | 17.45 | aA |
| 13 | NC | 1.062 | – |
| 14 | RB | 20.00 | Ω |
| 15 | IRB | 1.000 | μA |
| 16 | RBM | 20.00 | Ω |
| 17 | RE | 1.171 | Ω |
| 18 | RC | 4.350 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 284.7 | fF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.303 | – |
| 25 | TF | 7.037 | ps |
| 26 | XTF | 12.34 | – |
| 27 | VTF | 1.701 | V |
| 28 | ITF | 30.64 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 242.4 | fF |
| 31 | VJC | 188.6 | mV |
| 32 | MJC | 0.041 | – |
| 33 | XCJC | 0.130 | – |
| 34 | TR | 1.332 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.897 | – |

Note

1. These parameters have not been extracted, the default values are shown.



List of components (see Fig.21).

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 70 | fF |
| C_{cb} | 50 | fF |
| C_{ce} | 115 | fF |
| L1 | 0.34 | nH |
| L2 | 0.10 | nH |
| L3 | 0.25 | nH |
| L_B | 0.40 | nH |
| L_E | 0.40 | nH |

NPN 9 GHz wideband transistor

BFG520; BFG520/X; BFG520/XR

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

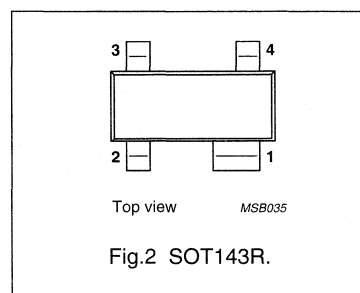
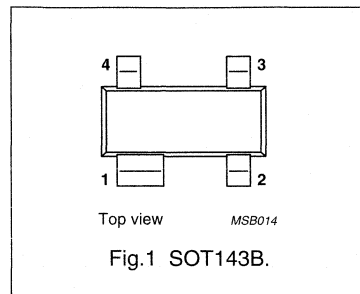
DESCRIPTION

NPN silicon planar epitaxial transistors, intended for applications in the RF frontend in the GHz range, such as analog and digital cellular telephones, cordless telephones (CT1, CT2, DECT, etc.), radar detectors, pagers and satellite TV tuners (SATV) and repeater amplifiers in fibre-optic systems.

The transistors are encapsulated in 4-pin, dual-emitter plastic SOT143 and SOT143R envelopes.

PINNING

| PIN | DESCRIPTION |
|-----------------------------|-------------|
| BFG520 (Fig.1) Code: N36 | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG520/X (Fig.1) Code: N42 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG520/XR (Fig.2) Code: N48 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | DC collector current | | – | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 88\text{ °C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_j = 25\text{ °C}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.3 | – | pF |
| f_T | transition frequency | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 19 | – | dB |
| | | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 17 | 18 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.1 | 1.6 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.9 | – | dB |

NPN 9 GHz wideband transistor

BFG520; BFG520/X; BFG520/XR

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 88\text{ °C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|-------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 88\text{ °C}$; note 1 | 290 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFG520; BFG520/X; BFG520/XR

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|---|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 6\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $I_C = I_e = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 1 | – | pF |
| C_C | collector capacitance | $I_E = I_e = 0; V_{CB} = 6\text{ V}; f = 1\text{ MHz}$ | – | 0.6 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 6\text{ V}; f = 1\text{ MHz}$ | – | 0.3 | – | pF |
| f_T | transition frequency | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; f = 1\text{ GHz};$ $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; f = 900\text{ MHz};$ $T_{amb} = 25\text{ °C}$ | – | 19 | – | dB |
| | | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; f = 2\text{ GHz};$ $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; f = 900\text{ MHz};$ $T_{amb} = 25\text{ °C}$ | 17 | 18 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 6\text{ V};$ $f = 900\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 1.1 | 1.6 | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 20\text{ mA}; V_{CE} = 6\text{ V};$ $f = 900\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 6\text{ V};$ $f = 2\text{ GHz}; T_{amb} = 25\text{ °C}$ | – | 1.9 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; R_L = 50\text{ }\Omega;$ $f = 900\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 17 | – | dBm |
| ITO | third order intercept point | note 2 | – | 26 | – | dBm |
| V_o | output voltage | note 3 | – | 275 | – | mV |
| d_2 | second order intermodulation distortion | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; V_o = 75\text{ mV};$ $T_{amb} = 25\text{ °C}; f_{(p+q)} = 810\text{ MHz}$ | – | –50 | – | dB |

Notes

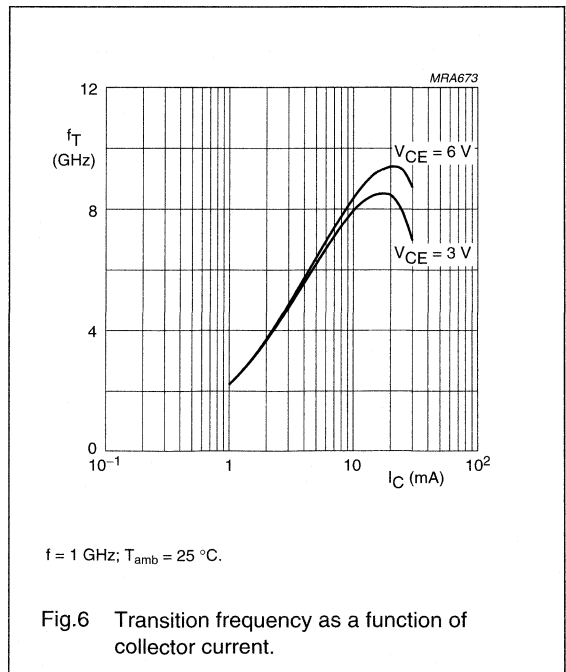
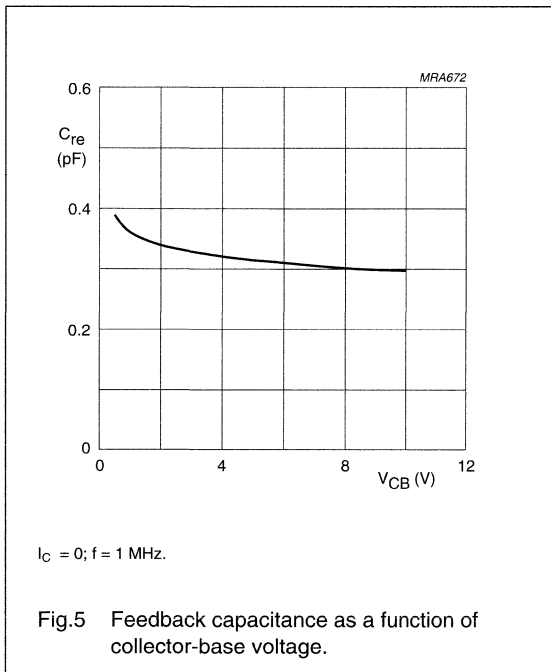
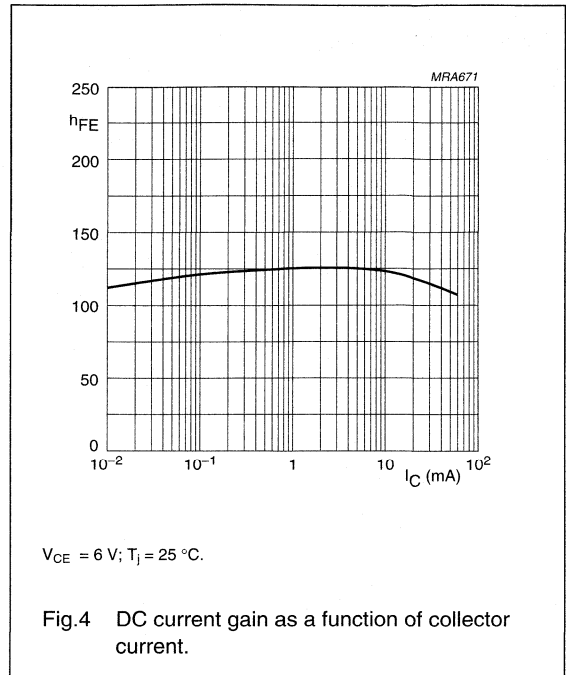
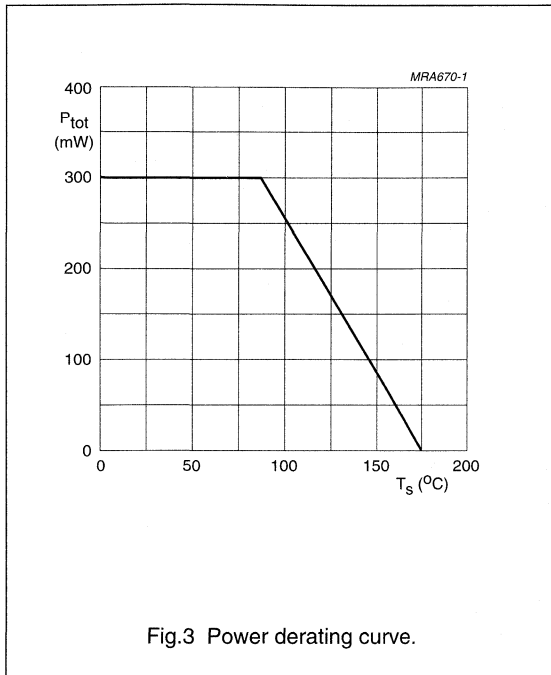
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{dB.}$$

2. $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; R_L = 50\text{ }\Omega; f = 900\text{ MHz}; T_{amb} = 25\text{ °C};$
 $f_p = 900\text{ MHz}; f_q = 902\text{ MHz};$
 measured at $f_{(2p-q)} = 898\text{ MHz}$ and $f_{(2q-p)} = 904\text{ MHz}.$
3. $d_{im} = -60\text{ dB}$ (DIN 45004B);
 $V_p = V_o; V_q = V_o - 6\text{ dB}; V_r = V_o - 6\text{ dB};$
 $f_p = 795.25\text{ MHz}; f_q = 803.25\text{ MHz}; f_r = 805.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 793.25\text{ MHz}$

NPN 9 GHz wideband transistor

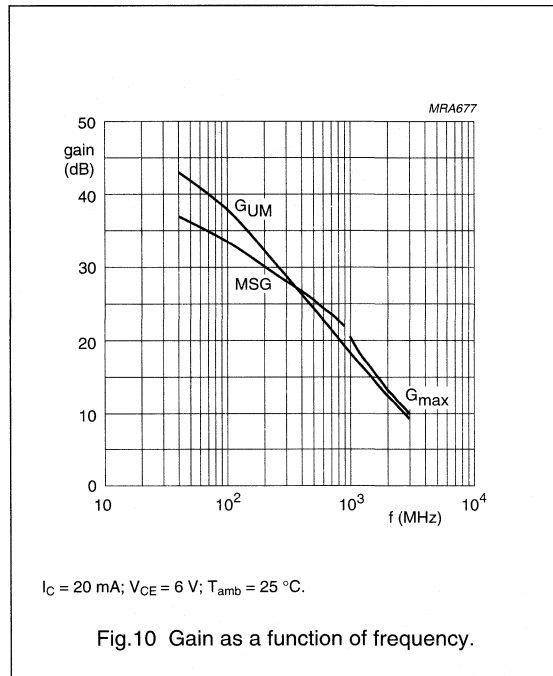
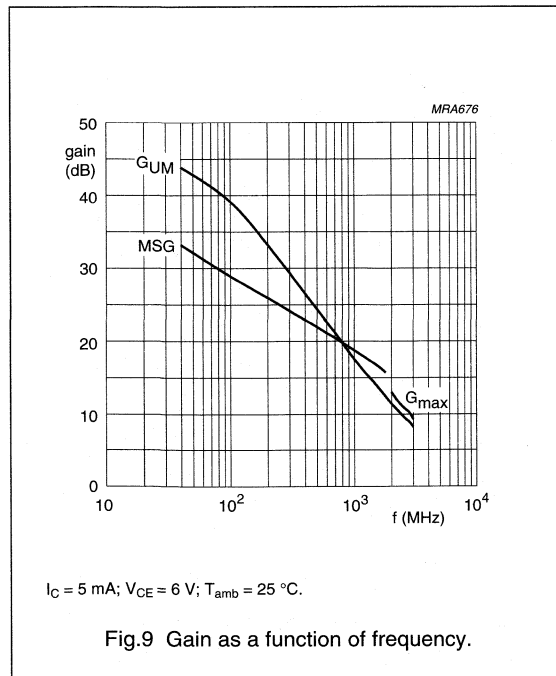
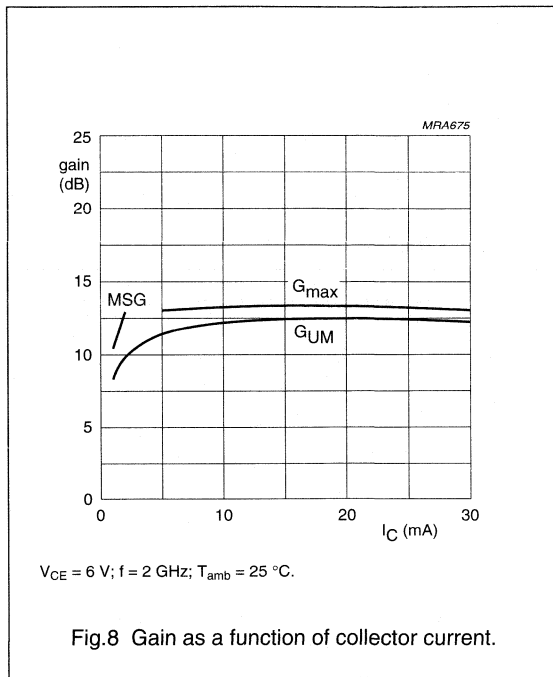
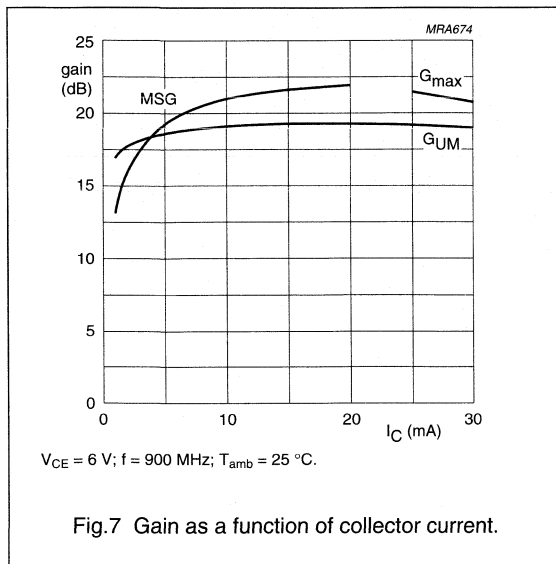
BFG520; BFG520/X; BFG520/XR



NPN 9 GHz wideband transistor

BFG520; BFG520/X; BFG520/XR

In Figs 7 to 10, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



NPN 9 GHz wideband transistor

BFG520; BFG520/X; BFG520/XR

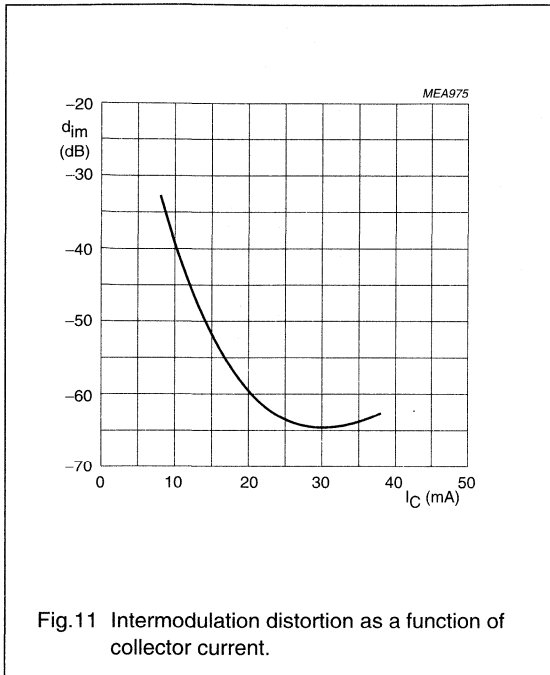


Fig.11 Intermodulation distortion as a function of collector current.

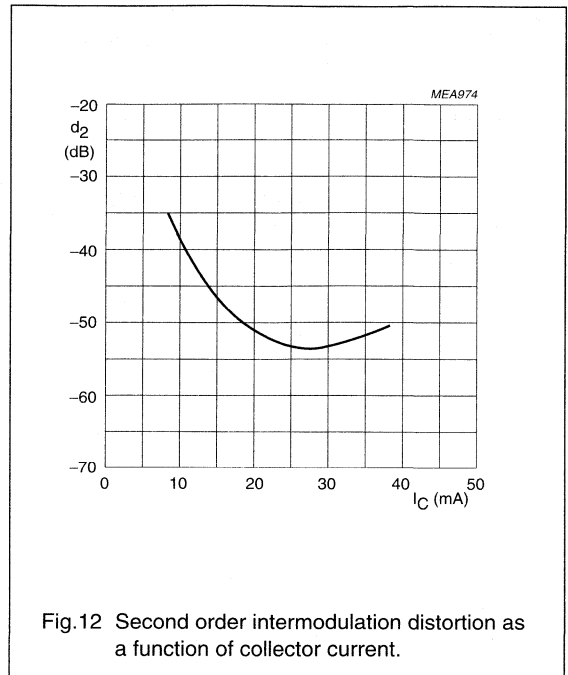
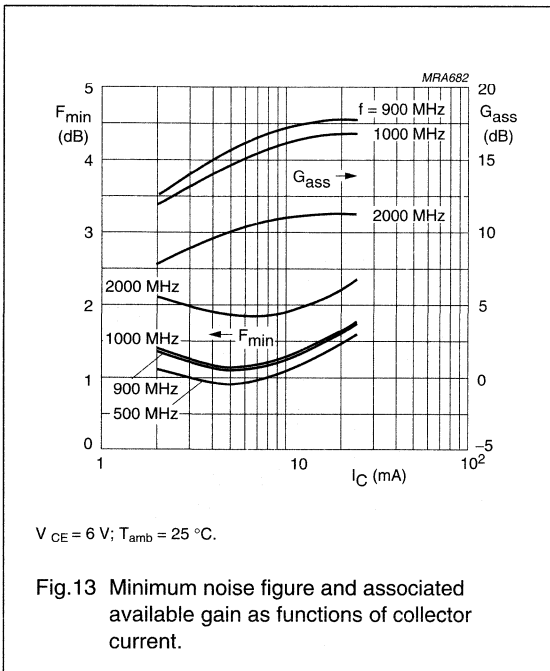
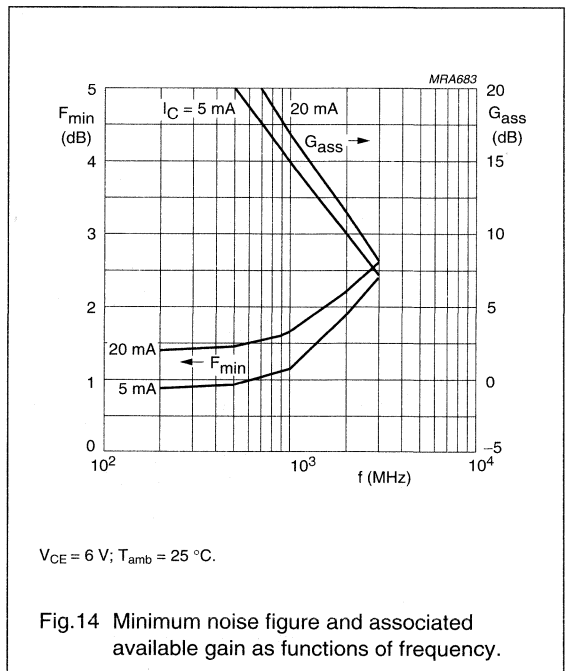


Fig.12 Second order intermodulation distortion as a function of collector current.



$V_{CE} = 6$ V; $T_{amb} = 25$ °C.

Fig.13 Minimum noise figure and associated available gain as functions of collector current.



$V_{CE} = 6$ V; $T_{amb} = 25$ °C.

Fig.14 Minimum noise figure and associated available gain as functions of frequency.

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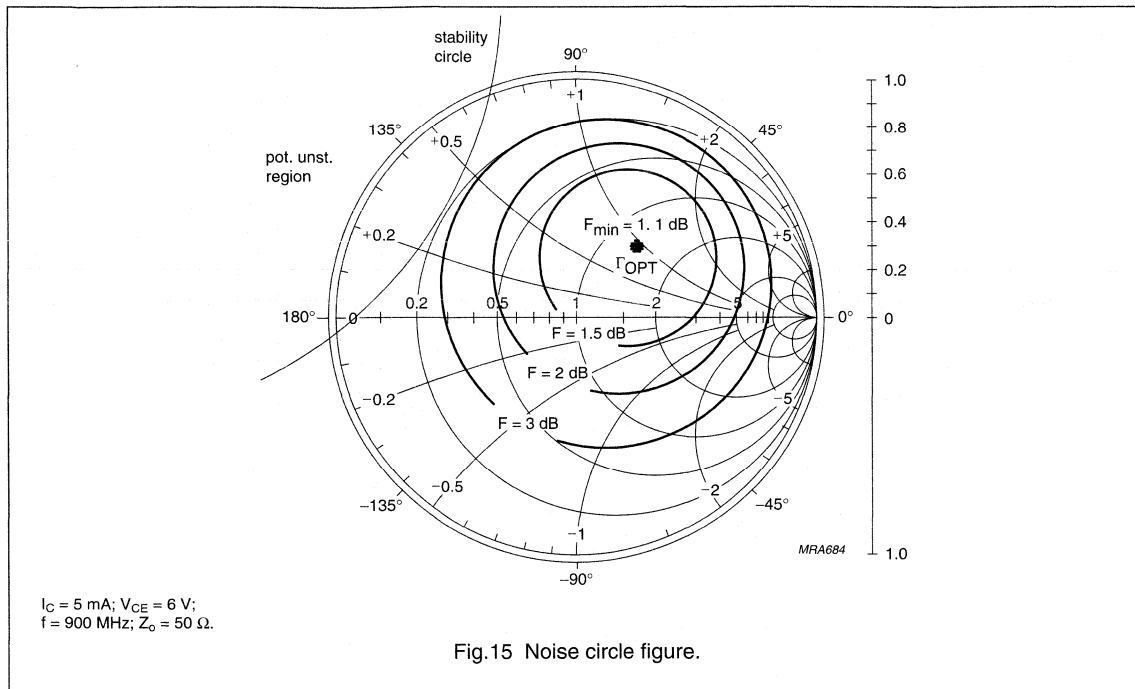


Fig.15 Noise circle figure.

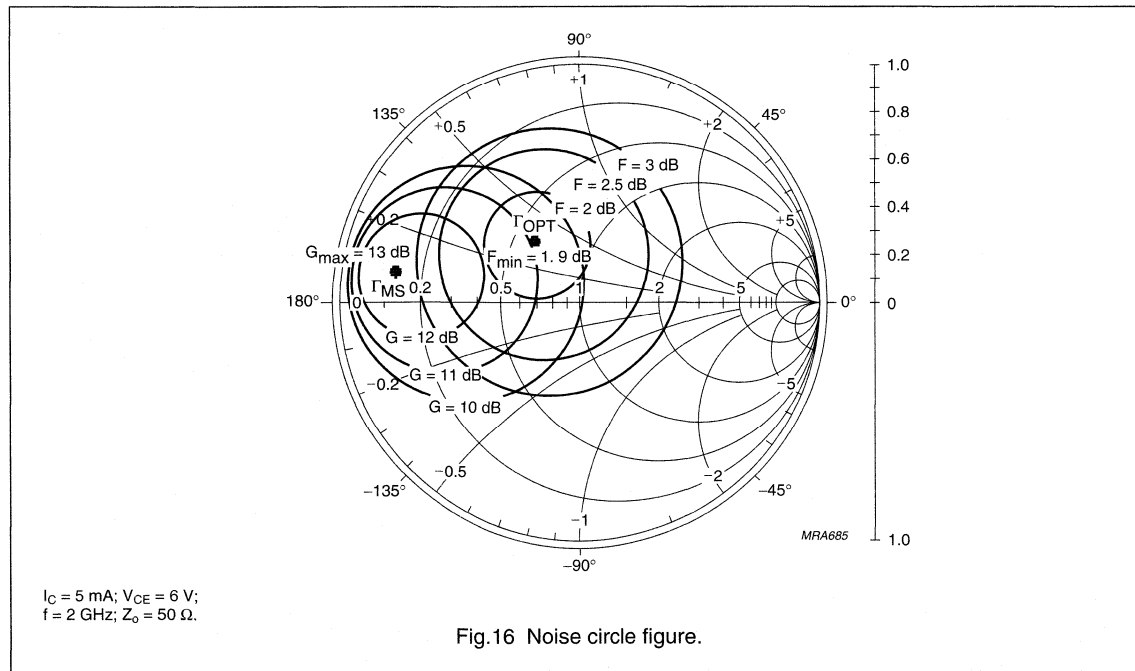
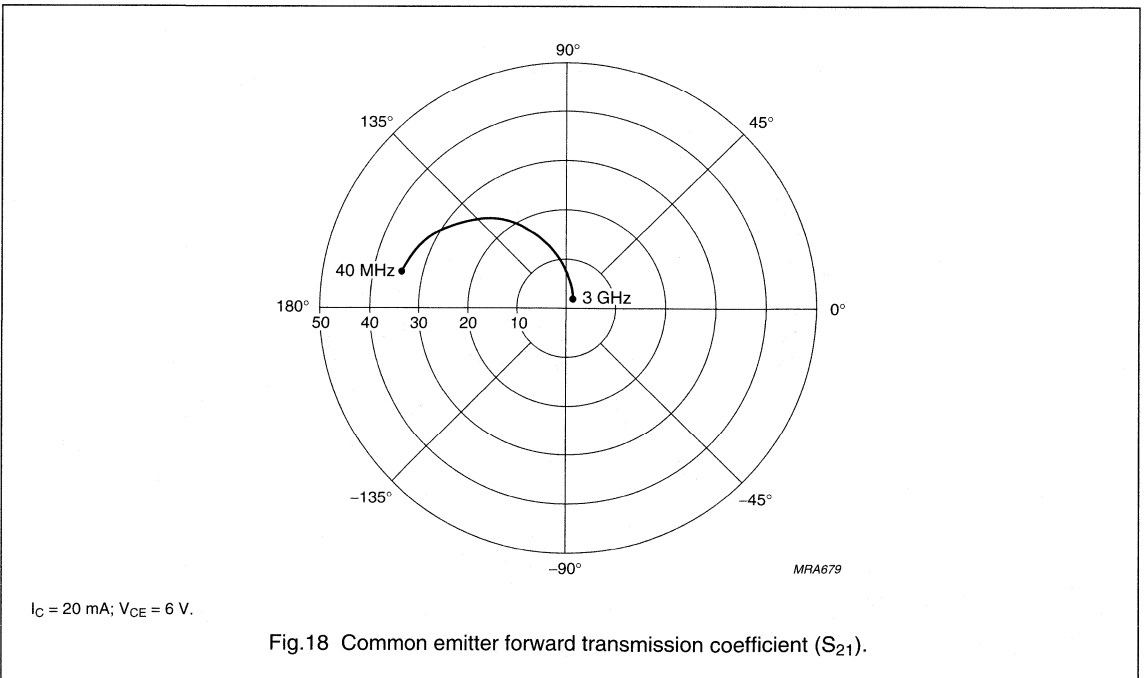
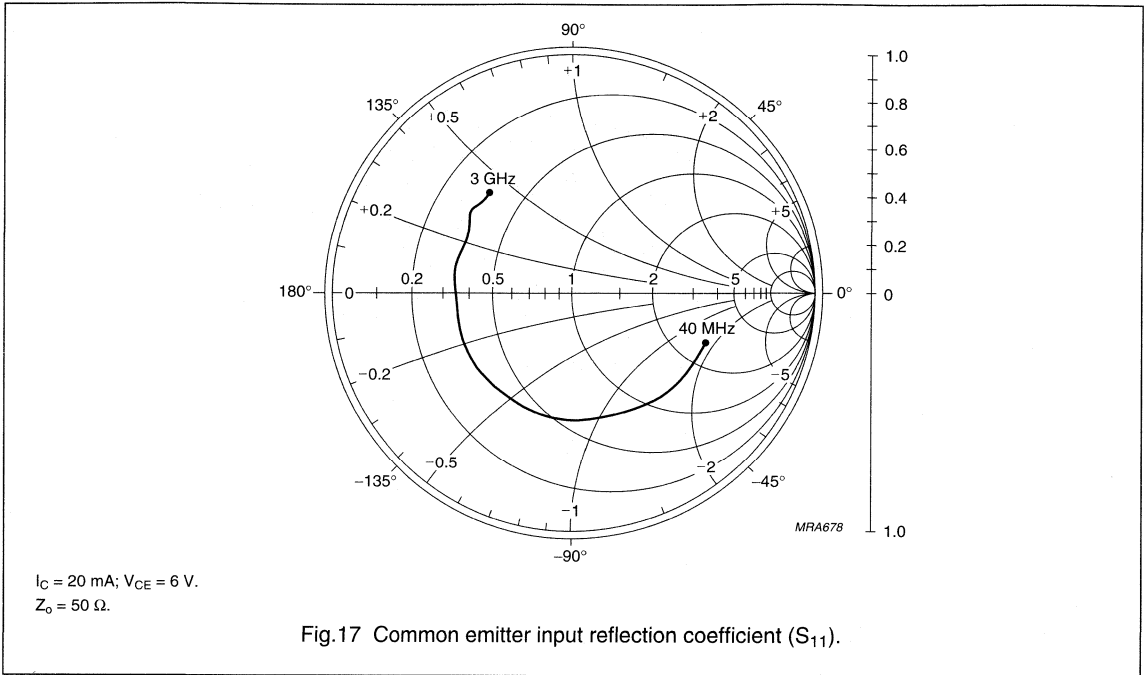


Fig.16 Noise circle figure.

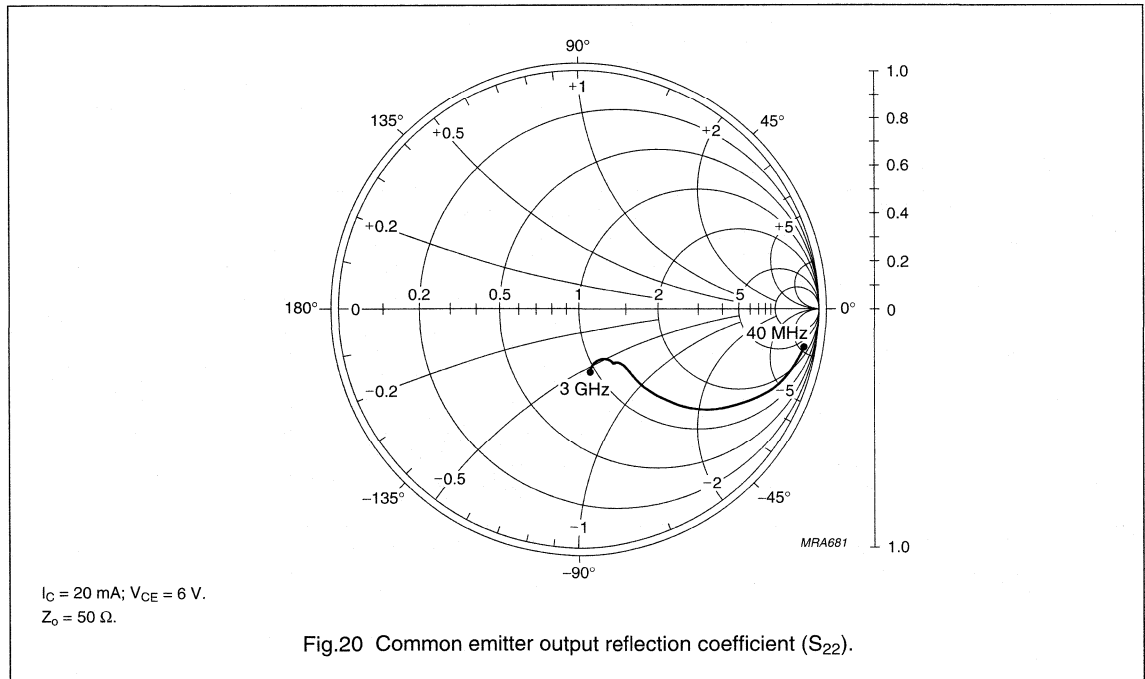
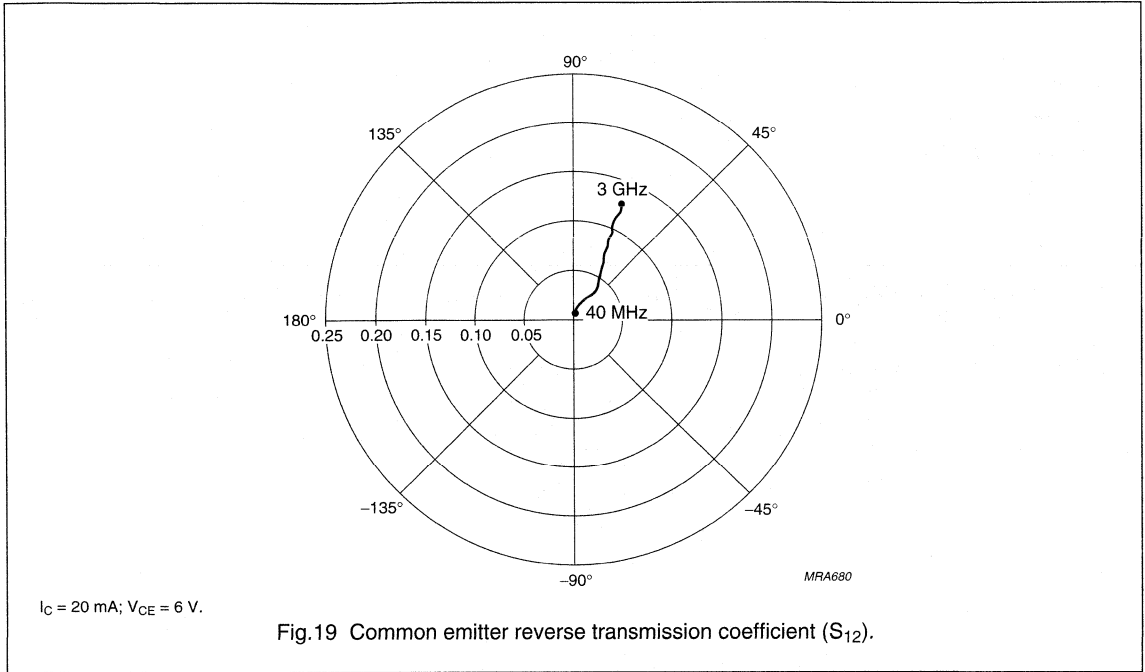
NPN 9 GHz wideband transistor

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NPN 9 GHz wideband transistor

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NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

APPLICATIONS

They are intended for applications in the RF front end, in wideband applications in the GHz range such as analog and digital cellular telephones, cordless telephones (CT2, CT3, PCN, DECT, etc.), radar detectors, pagers, satellite television tuners (SATV) and repeater amplifiers in fibre-optic systems.

DESCRIPTION

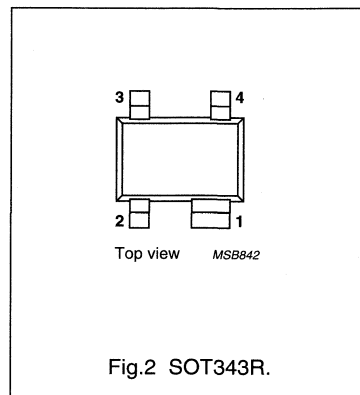
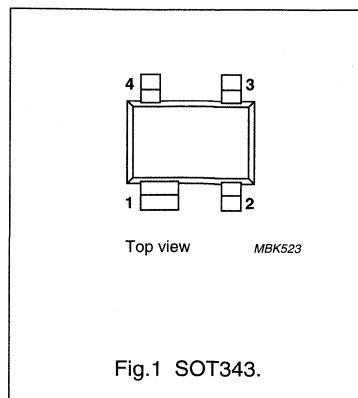
NPN silicon planar epitaxial transistors in plastic, 4-pin dual-emitter SOT343 and SOT343R packages.

MARKING

| TYPE NUMBER | CODE |
|-------------|------|
| BFG520W | N3 |
| BFG520W/X | N4 |
| BFG520W/XR | N5 |

PINNING

| PIN | DESCRIPTION |
|-------------------------------|-------------|
| BFG520W (see Fig.1) | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG520W/X (see Fig.1) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG520W/XR (see Fig.2) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | collector current (DC) | | – | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ }^\circ\text{C}$ | – | – | 500 | mW |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.35 | – | pF |
| f_T | transition frequency | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 17 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 16 | 17 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$ | – | 1.1 | 1.6 | dB |

NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR**LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 134).

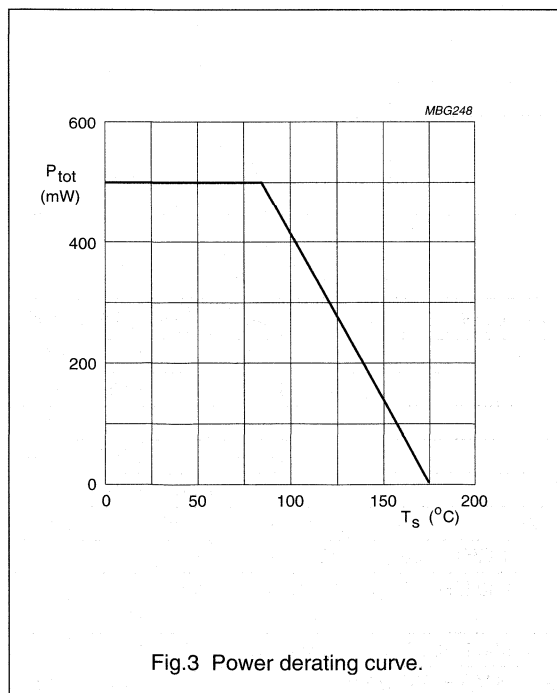
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ }^\circ\text{C}$; see Fig.3; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 175 | $^\circ\text{C}$ |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 85\text{ }^\circ\text{C}$; note 1 | 180 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.



NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR

CHARACTERISTICS

T_j = 25 °C (unless otherwise specified).

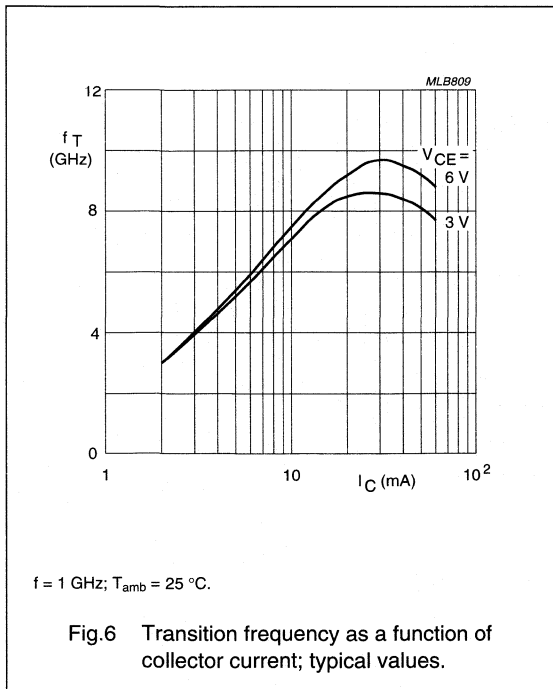
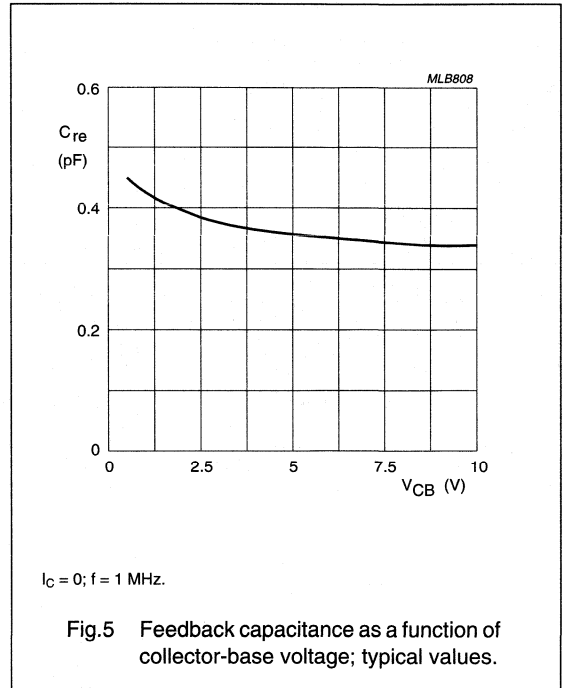
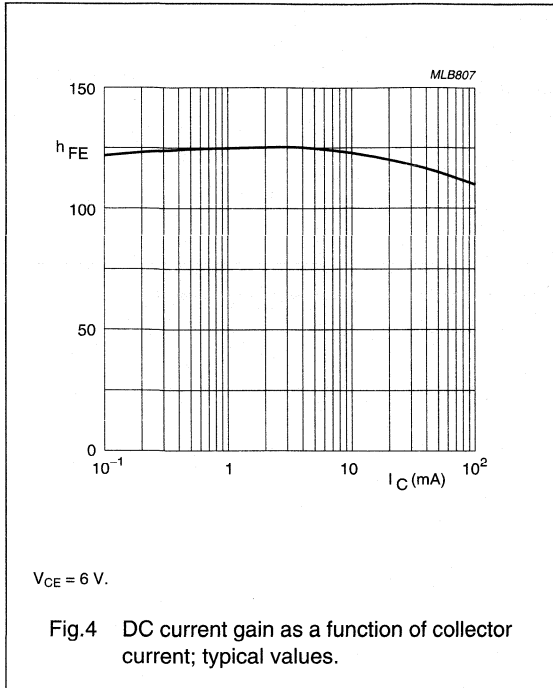
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------------------------|---|--|------|------|------|------|
| V _{(BR)CBO} | collector-base breakdown voltage | open emitter; I _C = 10 μA; I _E = 0 | 20 | – | – | V |
| V _{(BR)CES} | collector-emitter breakdown voltage | R _{BE} = 0; I _C = 10 μA | 15 | – | – | V |
| V _{(BR)EBO} | emitter-base breakdown voltage | open collector; I _E = 10 μA; I _C = 0 | 2.5 | – | – | V |
| I _{CBO} | collector cut-off current | open emitter; V _{CB} = 6 V; I _E = 0 | – | – | 50 | nA |
| h _{FE} | DC current gain | I _C = 20 mA; V _{CE} = 6 V | 60 | 120 | 250 | |
| C _{re} | feedback capacitance | I _C = 0; V _{CB} = 6 V; f = 1 MHz | – | 0.35 | – | pF |
| f _T | transition frequency | I _C = 20 mA; V _{CE} = 6 V; f = 1 GHz; T _{amb} = 25 °C | – | 9 | – | GHz |
| G _{UM} | maximum unilateral power gain; note 1 | I _C = 20 mA; V _{CE} = 6 V; f = 900 MHz; T _{amb} = 25 °C | – | 17 | – | dB |
| | | I _C = 20 mA; V _{CE} = 6 V; f = 2 GHz; T _{amb} = 25 °C | – | 11 | – | dB |
| s ₂₁ ² | insertion power gain | I _C = 20 mA; V _{CE} = 6 V; f = 900 MHz; T _{amb} = 25 °C | 16 | 17 | – | dB |
| F | noise figure | Γ _s = Γ _{opt} ; I _C = 5 mA; V _{CE} = 6 V; f = 900 MHz | – | 1.1 | 1.6 | dB |
| | | Γ _s = Γ _{opt} ; I _C = 20 mA; V _{CE} = 6 V; f = 900 MHz | – | 1.6 | 2.1 | dB |
| | | Γ _s = Γ _{opt} ; I _C = 5 mA; V _{CE} = 6 V; f = 2 GHz | – | 1.85 | – | dB |
| P _{L1} | output power at 1 dB gain compression | I _C = 20 mA; V _{CE} = 6 V; f = 900 MHz; R _L = 50 Ω; T _{amb} = 25 °C | – | 17 | – | dBm |
| ITO | third order intercept point | note 2 | – | 26 | – | dBm |
| V _o | output voltage | note 3 | – | 275 | – | mV |
| d ₂ | second order intermodulation distortion | note 4 | – | –50 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming s₁₂ is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.
- I_C = 20 mA; V_{CE} = 6 V; R_L = 50 Ω; T_{amb} = 25 °C;
f_p = 900 MHz; f_q = 902 MHz; measured at f_(2p-q) = 898 MHz and f_(2q-p) = 904 MHz.
- d_{im} = –60 dB (DIN45004B); I_C = 20 mA; V_{CE} = 6 V; V_p = V_o; V_q = V_o – 6 dB; V_r = V_o – 6 dB; R_L = 75 Ω;
f_p = 795.25 MHz; f_q = 803.25 MHz; f_r = 805.25 MHz; measured at f_(p+q-r) = 793.25 MHz.
- I_C = 20 mA; V_{CE} = 6 V; V_o = 75 mV; R_L = 75 Ω; T_{amb} = 25 °C;
f_p = 250 MHz; f_q = 560 MHz; measured at f_(p+q) = 810 MHz.

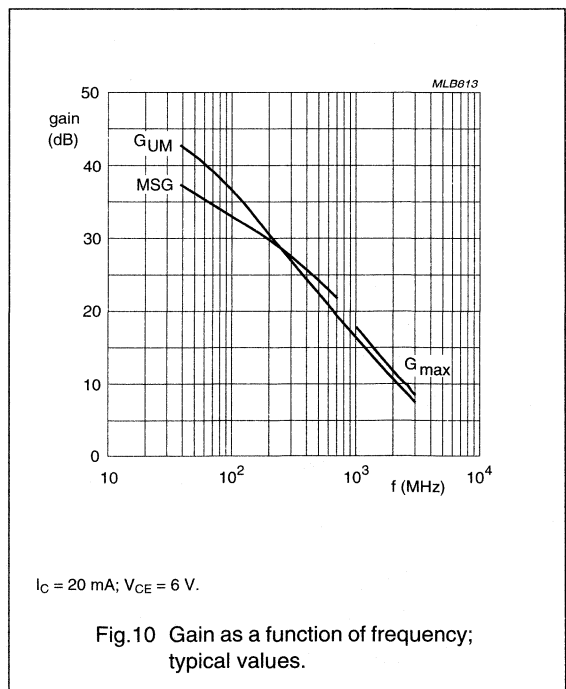
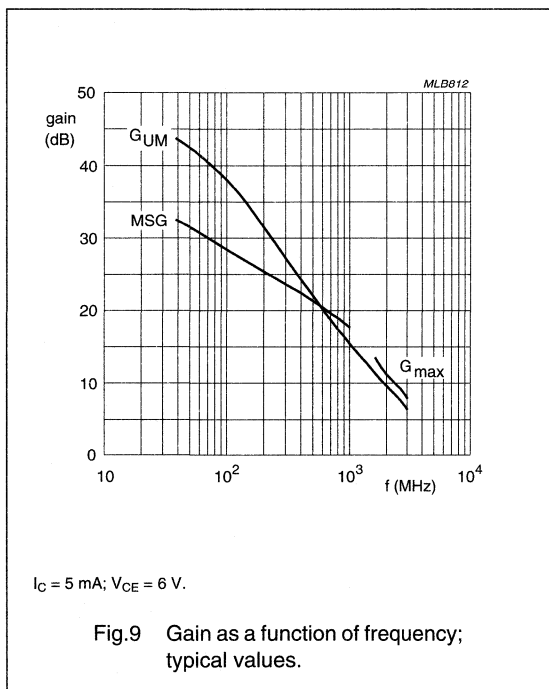
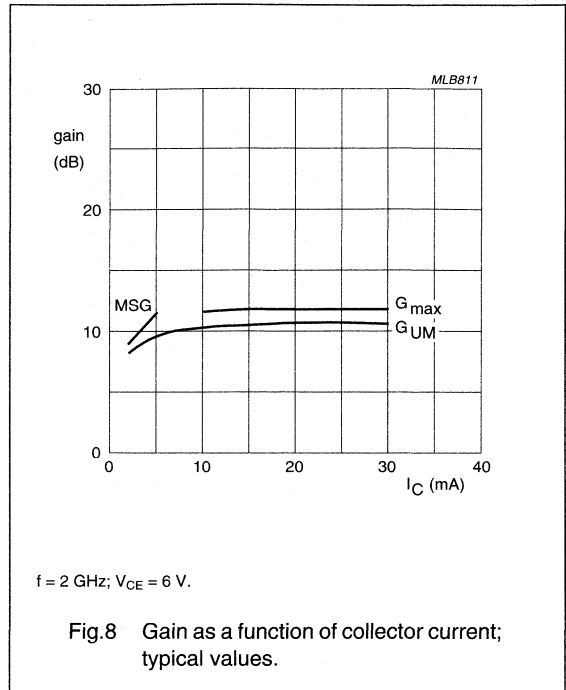
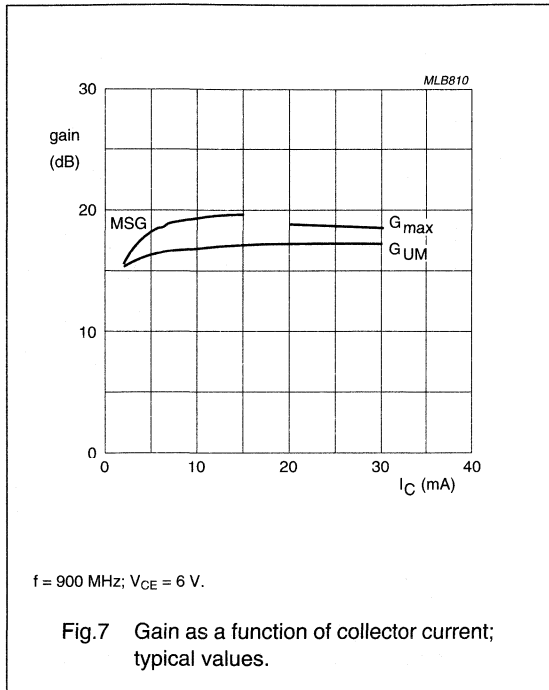
NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR



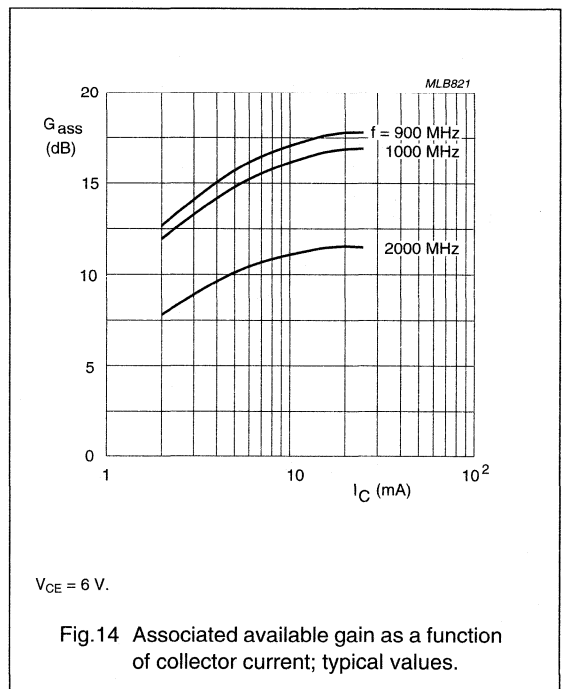
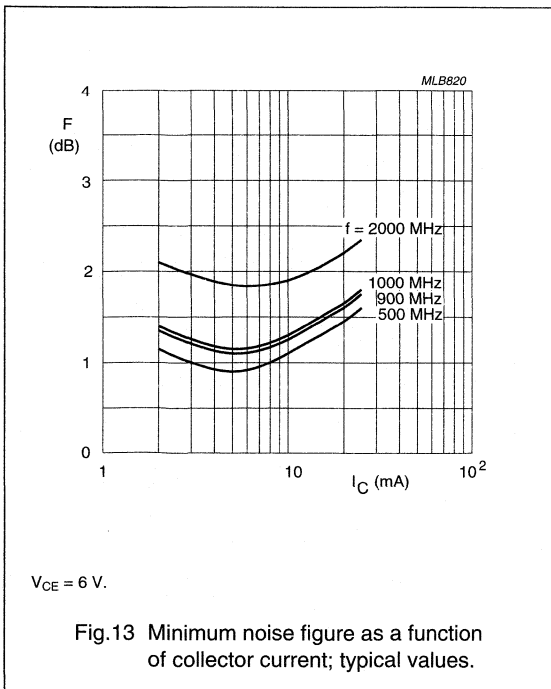
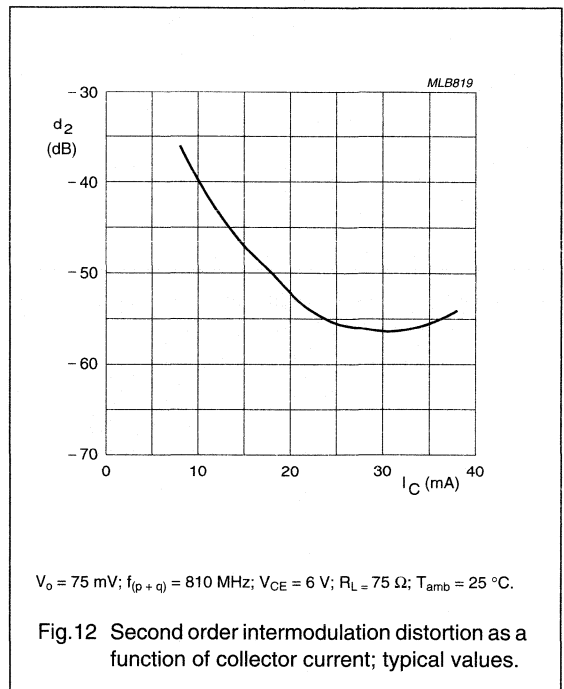
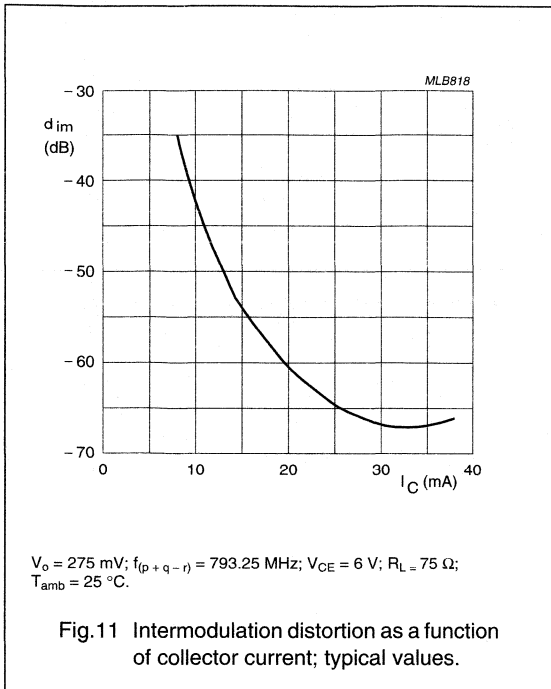
NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR



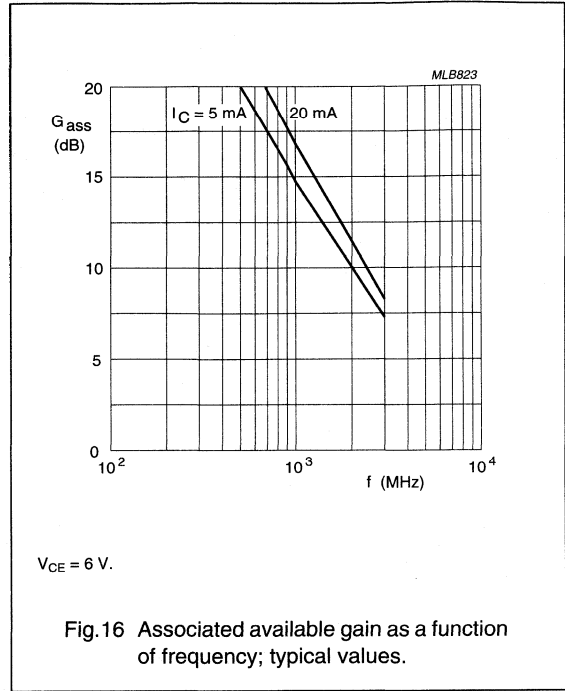
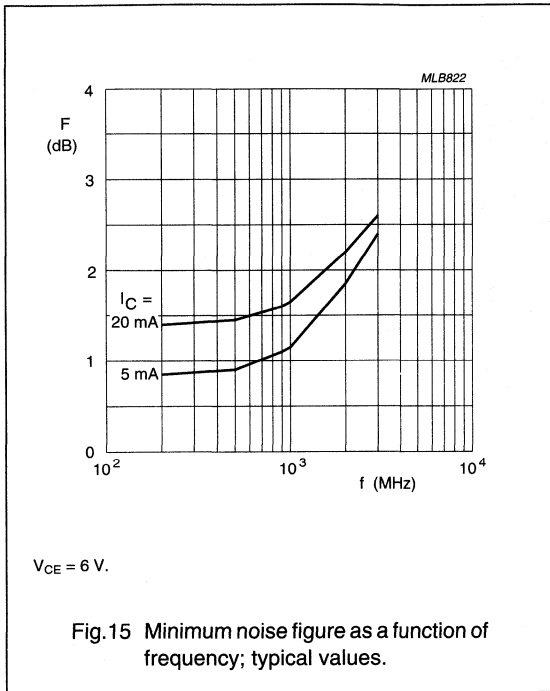
NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR



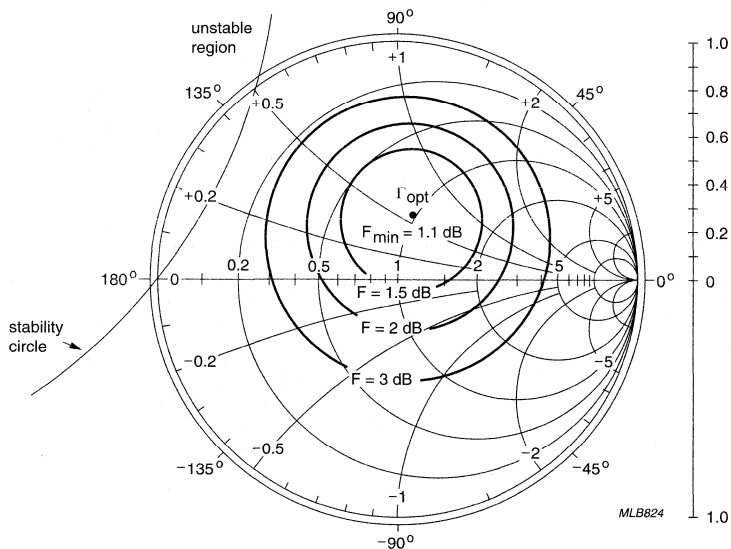
NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR



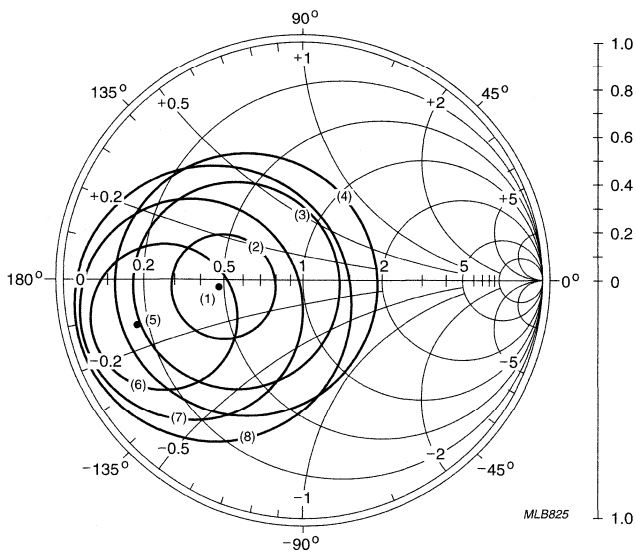
NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR



$f = 900 \text{ MHz}; V_{CE} = 6 \text{ V}; I_C = 5 \text{ mA}; Z_0 = 50 \Omega.$

Fig.17 Common emitter noise figure circles; typical values.



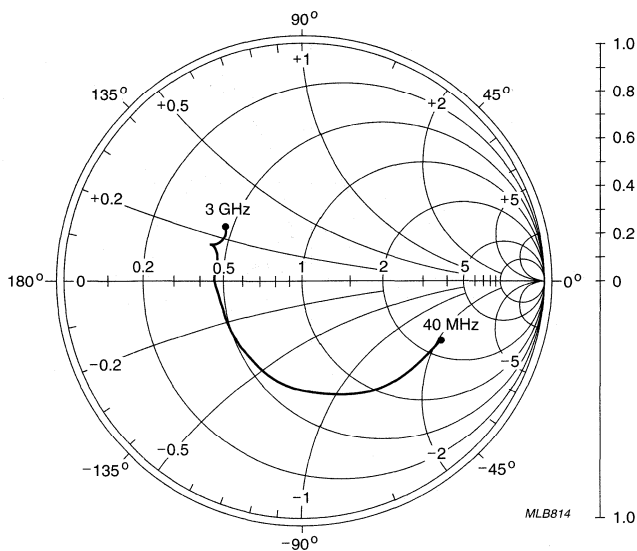
- (1) $\Gamma_{opt}; F_{min} = 1.85 \text{ dB}.$
- (2) $F = 2 \text{ dB}.$
- (3) $F = 2.5 \text{ dB}.$
- (4) $F = 3 \text{ dB}.$
- (5) $\Gamma_{ms}; G_{max} = 11.8 \text{ dB}.$
- (6) $G = 11 \text{ dB}.$
- (7) $G = 10 \text{ dB}.$
- (8) $G = 9 \text{ dB}.$

$f = 2 \text{ GHz}; V_{CE} = 6 \text{ V}; I_C = 5 \text{ mA}; Z_0 = 50 \Omega.$

Fig.18 Common emitter noise figure circles; typical values.

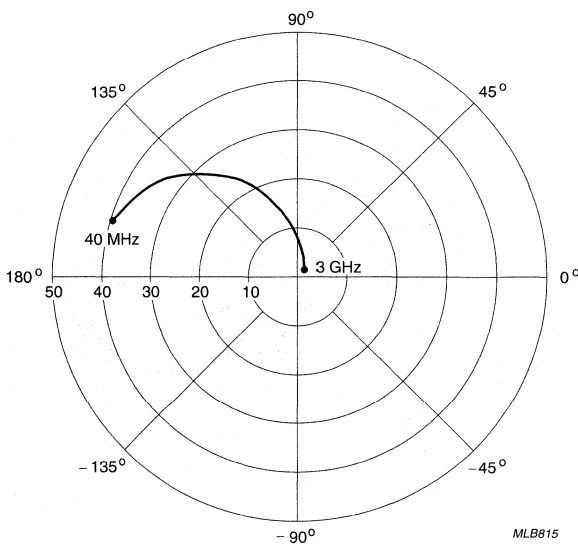
NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR



$V_{CE} = 6\text{ V}$; $I_C = 20\text{ mA}$; $Z_0 = 50\ \Omega$.

Fig.19 Common emitter input reflection coefficient (s_{11}); typical values.

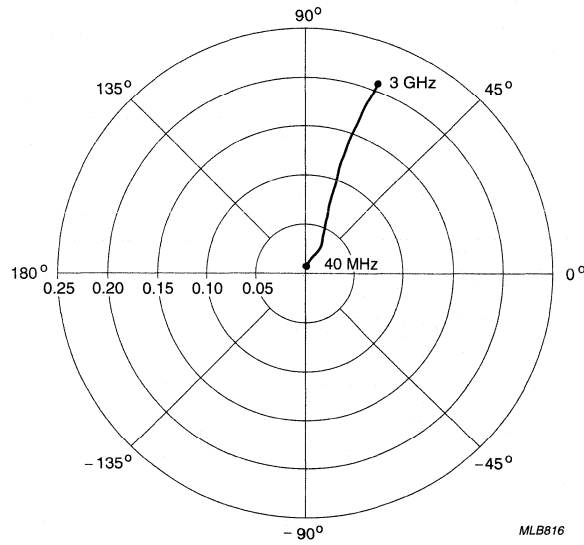


$V_{CE} = 6\text{ V}$; $I_C = 20\text{ mA}$.

Fig.20 Common emitter forward transmission coefficient (s_{21}); typical values.

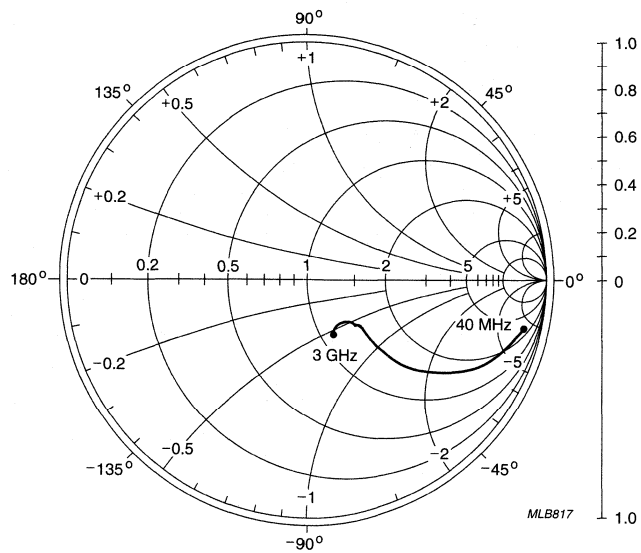
NPN 9 GHz wideband transistor

BFG520W
BFG520W/X; BFG520W/XR



$V_{CE} = 6\text{ V}; I_C = 20\text{ mA}$.

Fig.21 Common emitter reverse transmission coefficient (s_{12}); typical values.



$V_{CE} = 6\text{ V}; I_C = 20\text{ mA}; Z_0 = 50\ \Omega$.

Fig.22 Common emitter output reflection coefficient (s_{22}); typical values.

NPN 9 GHz wideband transistor

BFG520W BFG520W/X; BFG520W/XR

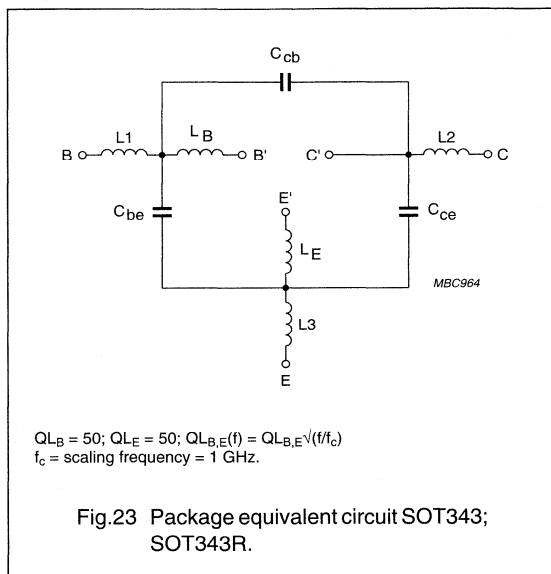
SPICE parameters for the BFG520W crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|------|
| 1 | IS | 1.016 | fA |
| 2 | BF | 220.1 | – |
| 3 | NF | 1.000 | – |
| 4 | VAF | 48.06 | V |
| 5 | IKF | 510 | mA |
| 6 | ISE | 283 | fA |
| 7 | NE | 2.035 | – |
| 8 | BR | 100.7 | – |
| 9 | NR | 0.988 | – |
| 10 | VAR | 1.692 | V |
| 11 | IKR | 2.352 | mA |
| 12 | ISC | 24.48 | aA |
| 13 | NC | 1.022 | – |
| 14 | RB | 10.00 | Ω |
| 15 | IRB | 1.000 | μA |
| 16 | RBM | 10.00 | Ω |
| 17 | RE | 775.3 | mΩ |
| 18 | RC | 2.210 | Ω |
| 19 (1) | XTB | 0.000 | – |
| 20 (1) | EG | 1.110 | eV |
| 21 (1) | XTI | 3.000 | – |
| 22 | CJE | 1.245 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.258 | – |
| 25 | TF | 8.616 | ps |
| 26 | XTF | 6.788 | – |
| 27 | VTF | 1.414 | V |
| 28 | ITF | 110.3 | mA |
| 29 | PTF | 45.01 | deg |
| 30 | CJC | 447.6 | fF |
| 31 | VJC | 189.2 | mV |
| 32 | MJC | 0.070 | – |
| 33 | XCJC | 0.130 | – |
| 34 | TR | 543.7 | ps |
| 35 (1) | CJS | 0.000 | F |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|------|
| 36 (1) | VJS | 750.0 | mV |
| 37 (1) | MJS | 0.000 | – |
| 38 | FC | 0.780 | – |

Note

1. These parameters have not been extracted, the default values are shown.



List of components (see Fig.23)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 70 | fF |
| C_{cb} | 50 | fF |
| C_{ce} | 115 | fF |
| L1 | 0.34 | nH |
| L2 | 0.10 | nH |
| L3 | 0.25 | nH |
| L_B | 0.40 | nH |
| L_E | 0.40 | nH |

NPN 9 GHz wideband transistor

BFG540; BFG540/X;
BFG540/XR

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

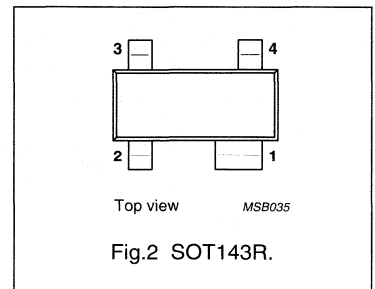
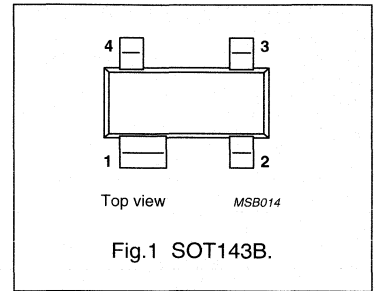
DESCRIPTION

NPN silicon planar epitaxial transistors, intended for wideband applications in the GHz range, such as analog and digital cellular telephones, cordless telephones (CT1, CT2, DECT, etc.), radar detectors, satellite TV tuners (SATV), MATV/CATV amplifiers and repeater amplifiers in fibre-optical systems.

The transistors are mounted in plastic SOT143B and SOT143R packages.

PINNING

| PIN | DESCRIPTION |
|-----------------------------|-------------|
| BFG540 (Fig.1) Code: N37 | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG540/X (Fig.1) Code: N43 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG540/XR (Fig.2) Code: N49 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



NPN 9 GHz wideband transistor

BFG540; BFG540/X;
BFG540/XR

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | DC collector current | | – | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 60\text{ °C}$; note 1 | – | – | 400 | mW |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_j = 25\text{ °C}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| f_T | transition frequency | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 18 | – | dB |
| | | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 11 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 15 | 16 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.3 | 1.8 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.9 | 2.4 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 2.1 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 60\text{ °C}$ (note 1) | – | 400 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 150 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|-----------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 60\text{ °C}$ note 1 | 290 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

NPN 9 GHz wideband transistor

BFG540; BFG540/X;
BFG540/XR

CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

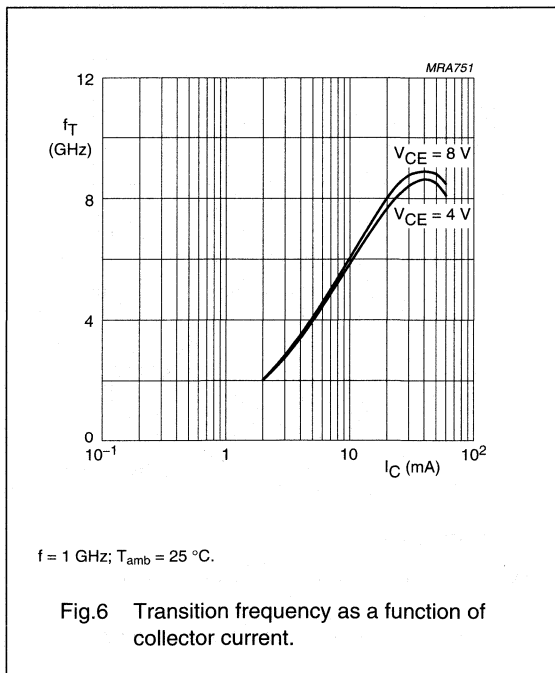
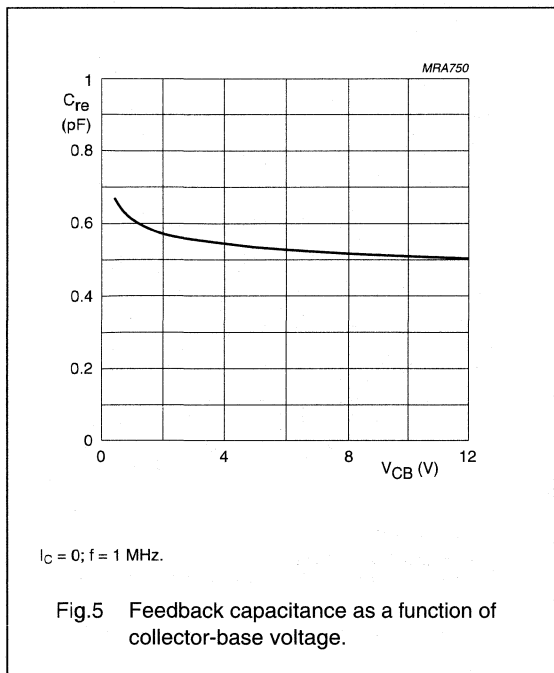
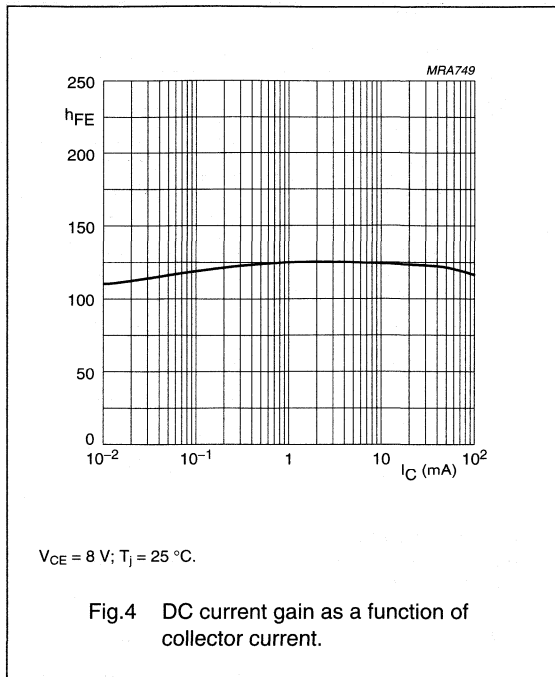
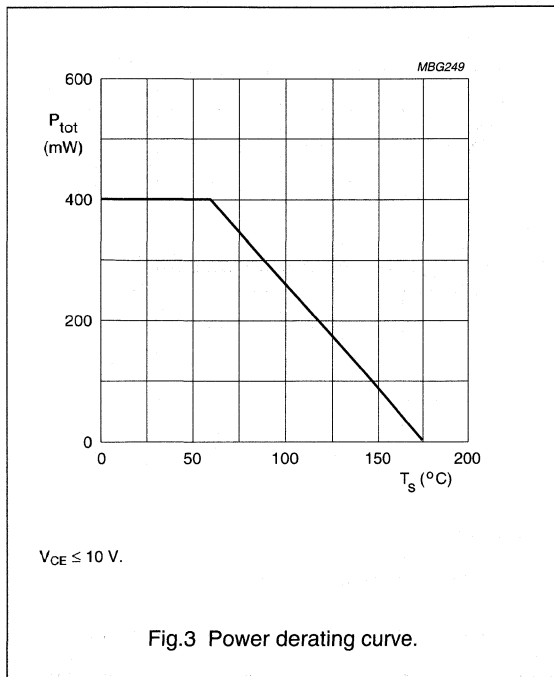
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|---|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 8\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}; V_{CE} = 8\text{ V}$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $I_C = I_e = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 2 | – | pF |
| C_c | collector capacitance | $I_E = I_e = 0; V_{CB} = 8\text{ V}; f = 1\text{ MHz}$ | – | 0.9 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 8\text{ V}; f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| f_T | transition frequency | $I_C = 40\text{ mA}; V_{CE} = 8\text{ V}; f = 1\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 40\text{ mA}; V_{CE} = 8\text{ V}; f = 900\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 18 | – | dB |
| | | $I_C = 40\text{ mA}; V_{CE} = 8\text{ V}; f = 2\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 11 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 40\text{ mA}; V_{CE} = 8\text{ V}; f = 900\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | 15 | 16 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}; I_C = 10\text{ mA}; V_{CE} = 8\text{ V}; f = 900\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1.3 | 1.8 | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 40\text{ mA}; V_{CE} = 8\text{ V}; f = 900\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1.9 | 2.4 | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 10\text{ mA}; V_{CE} = 8\text{ V}; f = 2\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 2.1 | – | dB |
| PL_1 | output power at 1 dB gain compression | $I_C = 40\text{ mA}; V_{CE} = 8\text{ V}; R_L = 50\text{ } \Omega; f = 900\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 21 | – | dBm |
| ITO | third order intercept point | note 2 | – | 34 | – | dBm |
| V_O | output voltage | note 3 | – | 500 | – | mV |
| d_2 | second order intermodulation distortion | note 4 | – | –50 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB.
- $V_{CE} = 8\text{ V}; I_C = 40\text{ mA}; R_L = 50\text{ } \Omega; T_{amb} = 25\text{ }^\circ\text{C}; f_p = 900\text{ MHz}; f_q = 902\text{ MHz};$
measured at $f_{(2p-q)} = 898\text{ MHz}$ and $f_{(2q-p)} = 904\text{ MHz}$.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 40\text{ mA}; V_{CE} = 8\text{ V}; Z_L = Z_S = 75\text{ } \Omega; T_{amb} = 25\text{ }^\circ\text{C};$
 $V_p = V_O; V_q = V_O - 6\text{ dB}; V_r = V_O - 6\text{ dB};$
 $f_p = 795.25\text{ MHz}; f_q = 803.25\text{ MHz}; f_r = 805.25\text{ MHz};$
measured at $f_{(p+q-r)} = 793.25\text{ MHz}$.
- $I_C = 40\text{ mA}; V_{CE} = 8\text{ V}; V_O = 275\text{ mV}; T_{amb} = 25\text{ }^\circ\text{C};$
 $f_p = 250\text{ MHz}; f_q = 560\text{ MHz};$ measured at $f_{(p+q)} = 810\text{ MHz}$.

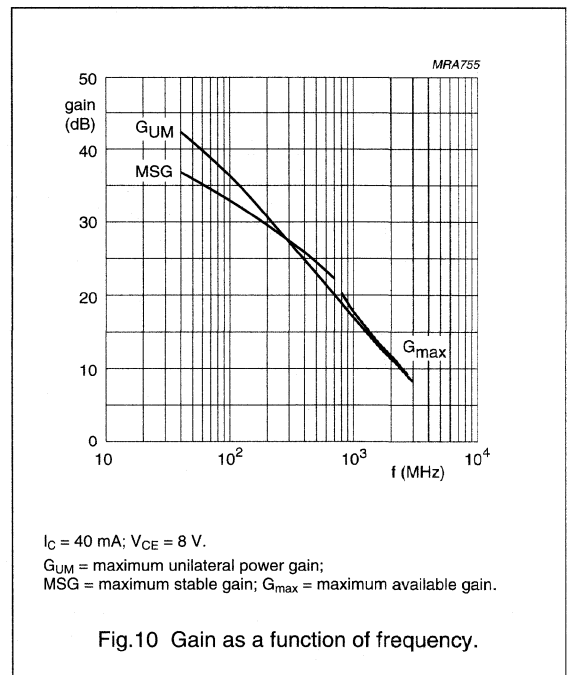
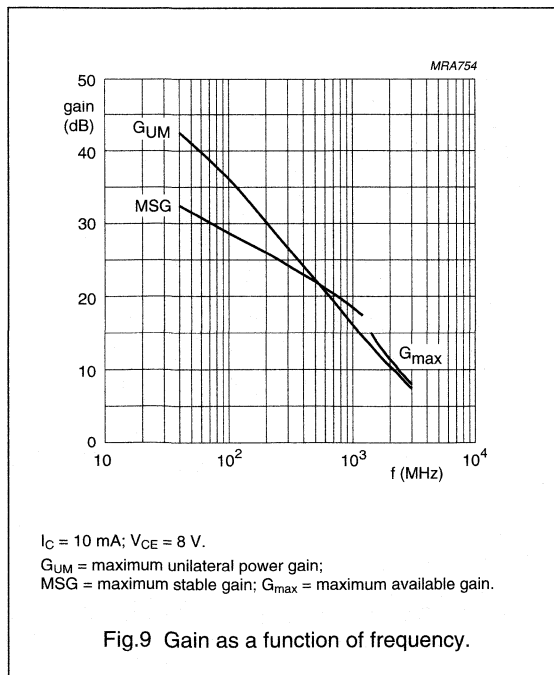
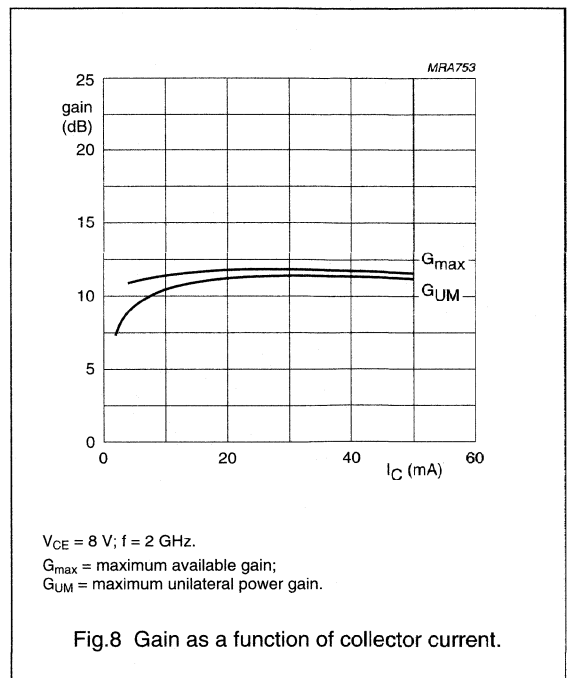
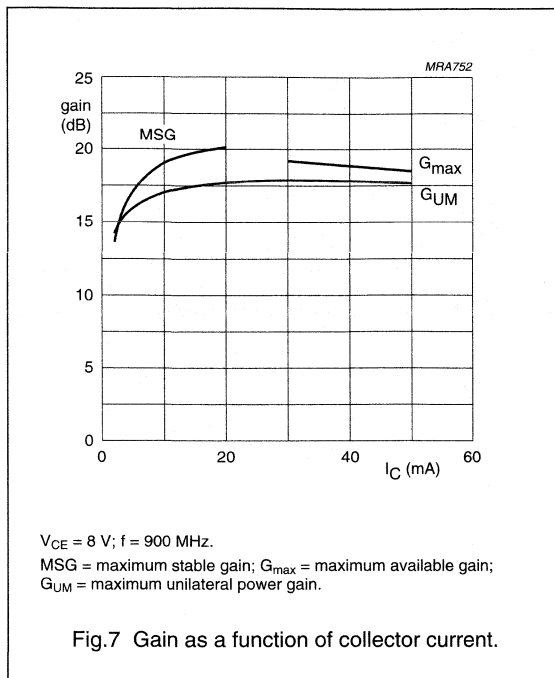
NPN 9 GHz wideband transistor

BFG540; BFG540/X;
BFG540/XR



NPN 9 GHz wideband transistor

BFG540; BFG540/X;
BFG540/XR



NPN 9 GHz wideband transistor

BFG540; BFG540/X;
BFG540/XR

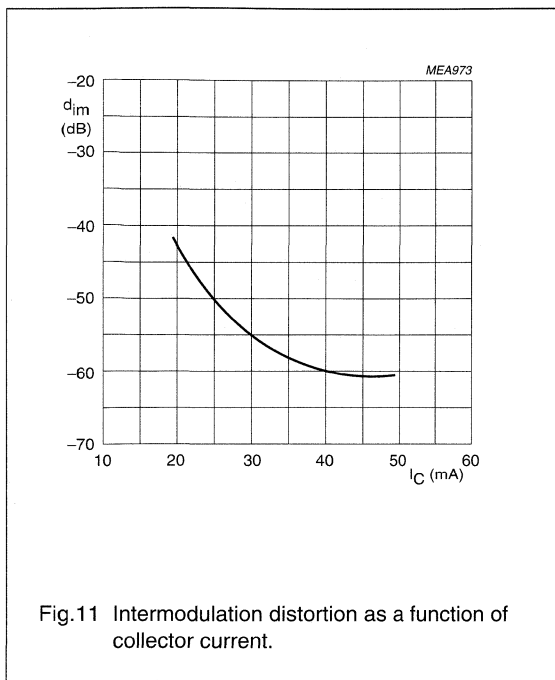


Fig.11 Intermodulation distortion as a function of collector current.

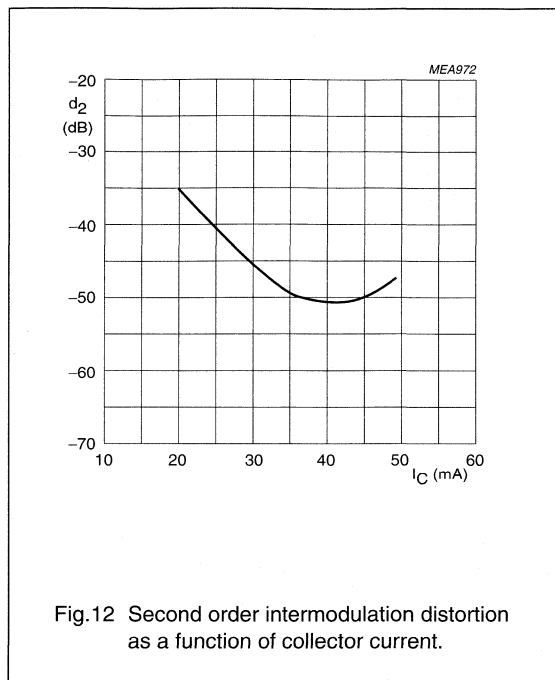
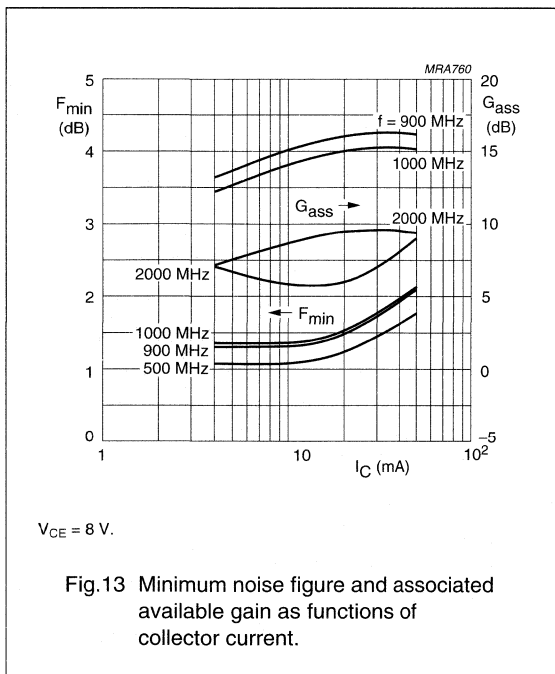
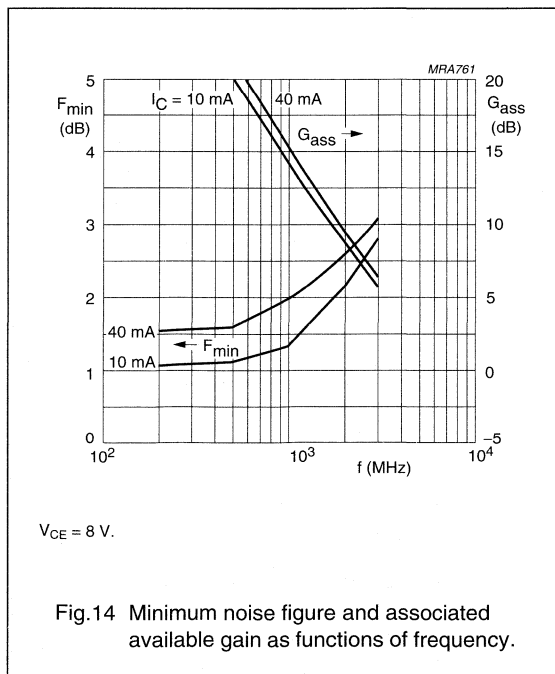


Fig.12 Second order intermodulation distortion as a function of collector current.



$V_{CE} = 8$ V.

Fig.13 Minimum noise figure and associated available gain as functions of collector current.

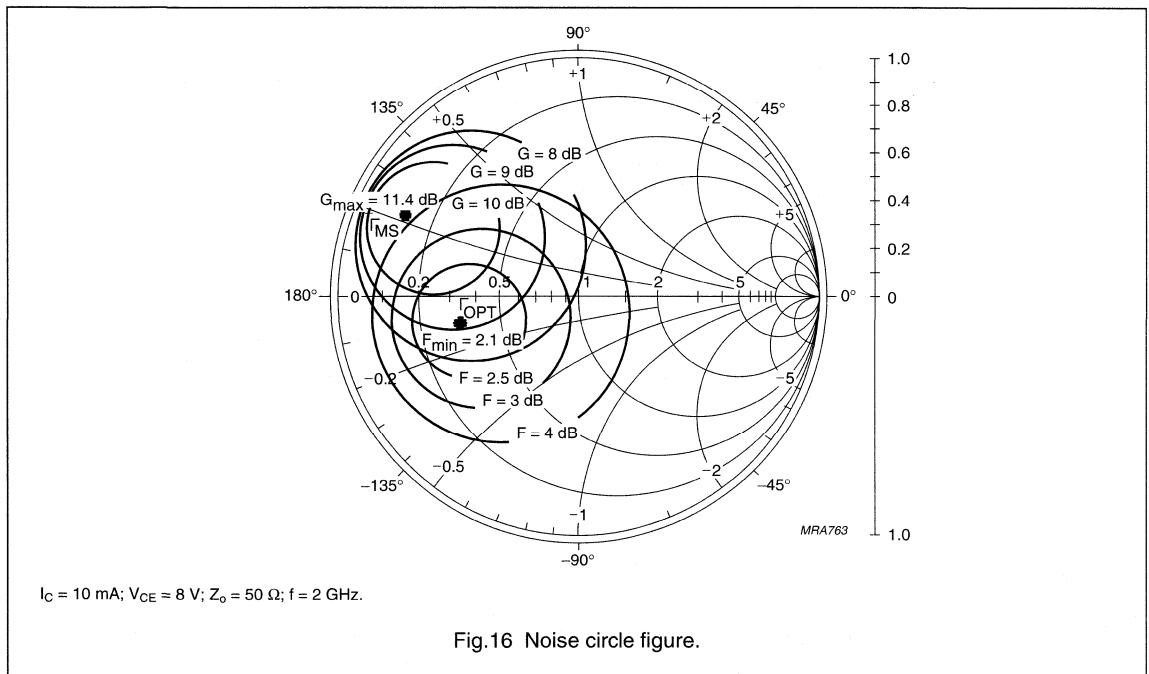
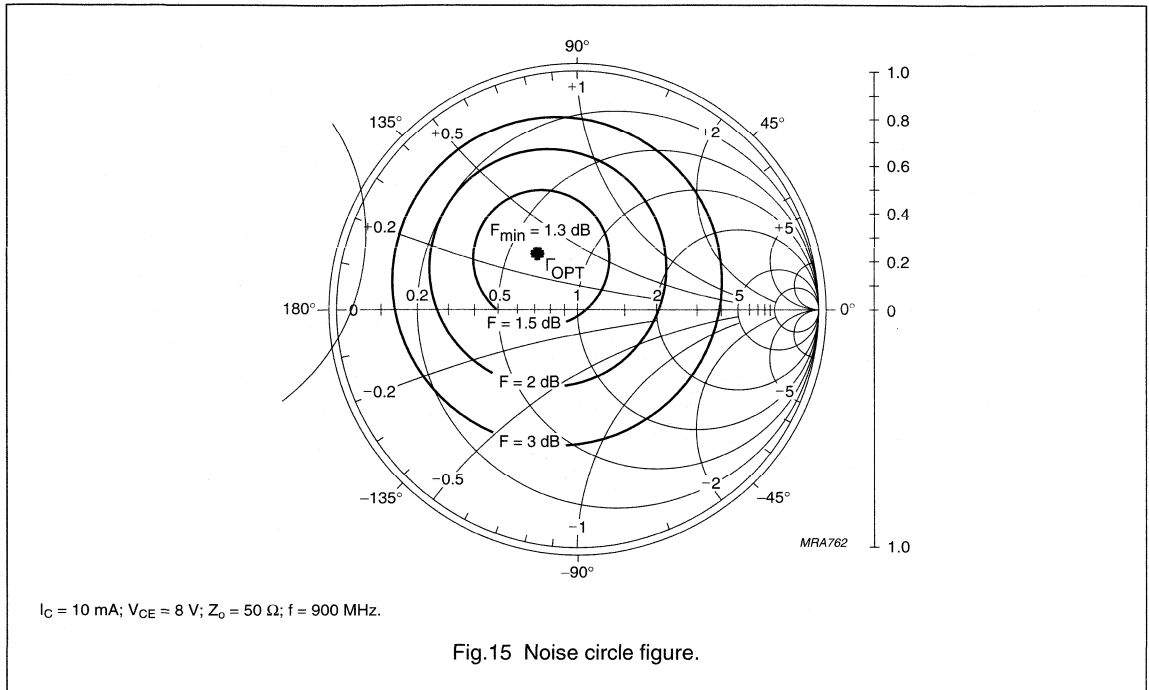


$V_{CE} = 8$ V.

Fig.14 Minimum noise figure and associated available gain as functions of frequency.

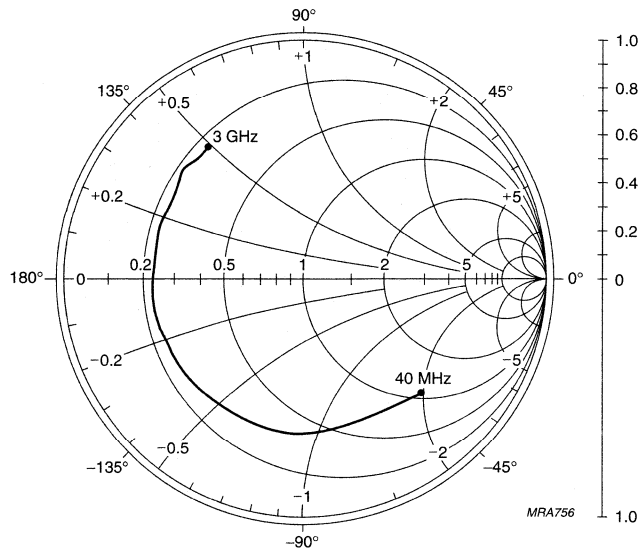
NPN 9 GHz wideband transistor

BFG540; BFG540/X;
BFG540/XR



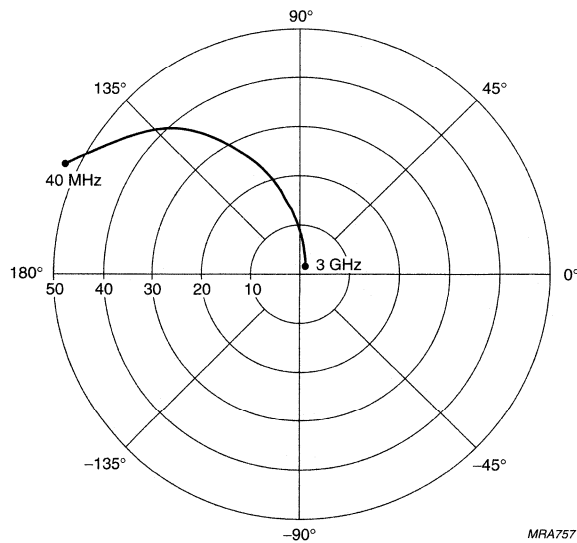
NPN 9 GHz wideband transistor

BFG540; BFG540/X;
BFG540/XR



$I_C = 40 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $Z_o = 50 \Omega$.

Fig.17 Common emitter input reflection coefficient (S_{11}).

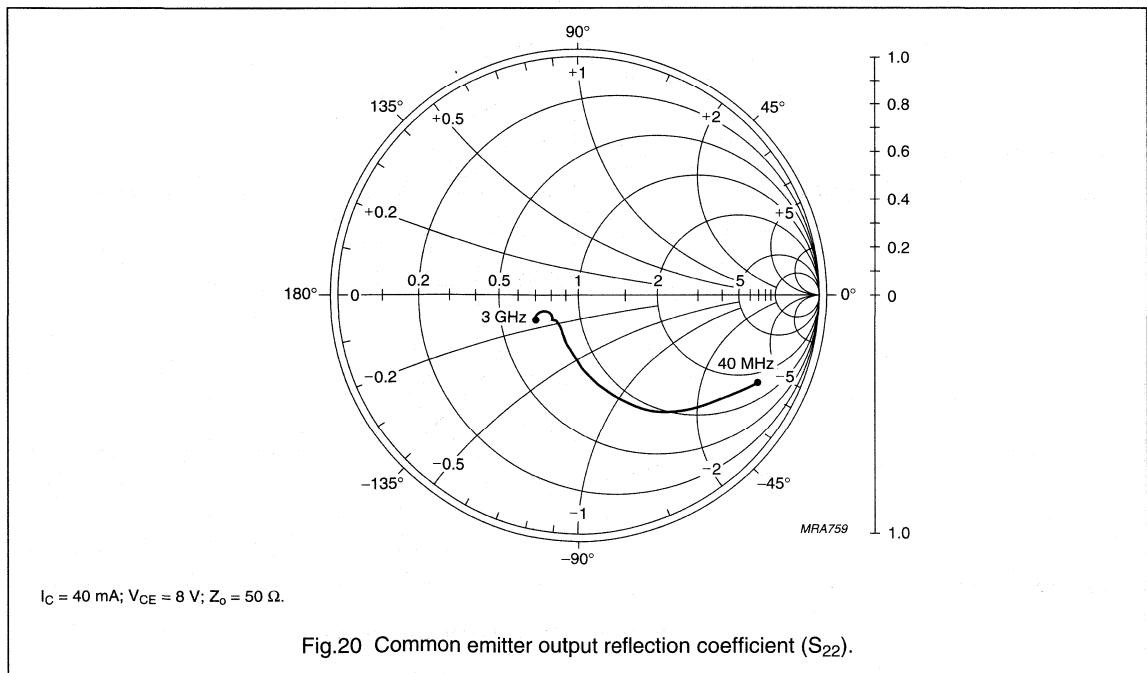
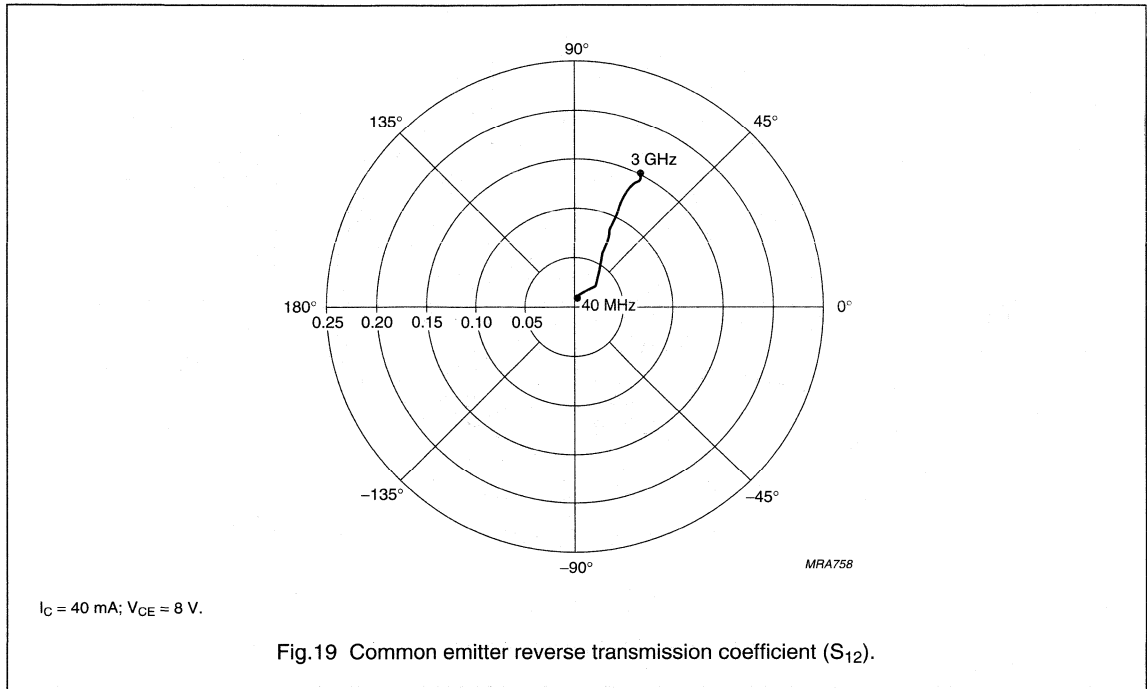


$I_C = 40 \text{ mA}$; $V_{CE} = 8 \text{ V}$.

Fig.18 Common emitter forward transmission coefficient (S_{21}).

NPN 9 GHz wideband transistor

BFG540; BFG540/X;
BFG540/XR



NPN 9 GHz wideband transistor

BFG540W
BFG540W/X; BFG540W/XR

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

APPLICATIONS

They are intended for applications in the RF front end, in wideband applications in the GHz range such as analog and digital cellular telephones, cordless telephones (CT2, CT3, PCN, DECT, etc.), radar detectors, pagers, satellite television tuners (SATV), MATV/CATV amplifiers and repeater amplifiers in fibre-optic systems.

DESCRIPTION

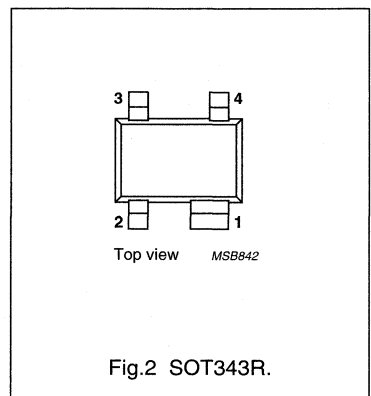
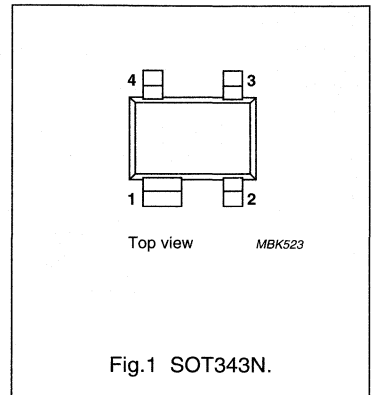
NPN silicon planar epitaxial transistors in plastic, 4-pin dual-emitter SOT343N and SOT343R packages.

MARKING

| TYPE NUMBER | CODE |
|-------------|------|
| BFG540W | N9 |
| BFG540W/X | N7 |
| BFG540W/XR | N8 |

PINNING

| PIN | DESCRIPTION |
|-------------------------------|-------------|
| BFG540W (see Fig.1) | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG540W/X (see Fig.1) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG540W/XR (see Fig.2) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | collector current (DC) | | – | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ °C}$ | – | – | 500 | mW |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| f_T | transition frequency | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 16 | – | dB |
| | | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 10 | – | dB |
| $ s_{21} ^2$ | insertion power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 14 | 15 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$ | – | 2.1 | – | dB |

NPN 9 GHz wideband transistor

BFG540W
BFG540W/X; BFG540W/XR

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

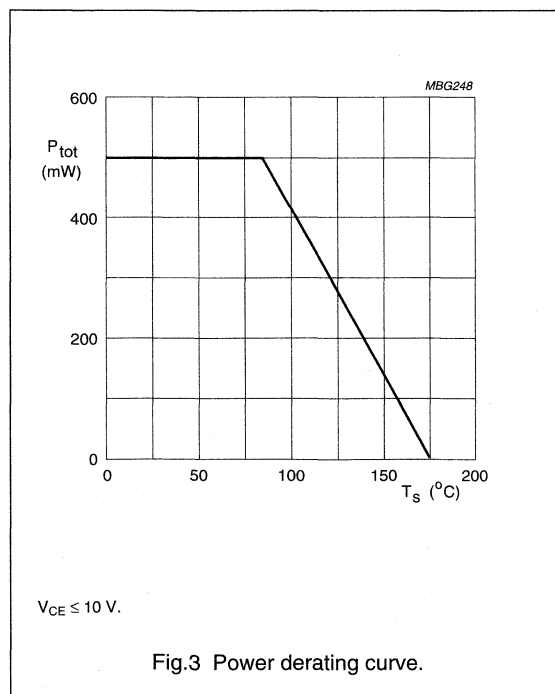
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ }^\circ\text{C}$; see Fig.3; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 175 | $^\circ\text{C}$ |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 85\text{ }^\circ\text{C}$; note 1 | 180 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.



NPN 9 GHz wideband transistor

BFG540W
BFG540W/X; BFG540W/XR

CHARACTERISTICS

T_j = 25 °C (unless otherwise specified).

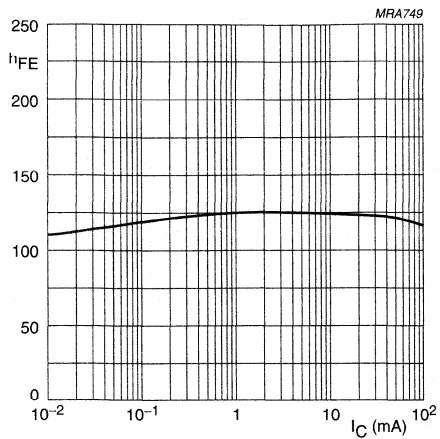
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------------------------|---|--|------|------|------|------|
| V _{(BR)CBO} | collector-base breakdown voltage | open emitter; I _C = 10 μA; I _E = 0 | 20 | – | – | V |
| V _{(BR)CES} | collector-emitter breakdown voltage | R _{BE} = 0; I _C = 40 μA | 15 | – | – | V |
| V _{(BR)EBO} | emitter-base breakdown voltage | open collector; I _E = 100 μA; I _C = 0 | 2.5 | – | – | V |
| I _{CBO} | collector cut-off current | open emitter; V _{CB} = 8 V; I _E = 0 | – | – | 50 | nA |
| h _{FE} | DC current gain | I _C = 40 mA; V _{CE} = 8 V | 60 | 120 | 250 | |
| f _T | transition frequency | I _C = 40 mA; V _{CE} = 8 V; f = 1 GHz; T _{amb} = 25 °C | – | 9 | – | GHz |
| C _c | collector capacitance | I _E = i _e = 0; V _{CB} = 8 V; f = 1 MHz | – | 0.9 | – | pF |
| C _e | emitter capacitance | I _C = i _c = 0; V _{EB} = 0.5 V; f = 1 MHz | – | 2 | – | pF |
| C _{re} | feedback capacitance | I _C = 0; V _{CB} = 8 V; f = 1 MHz | – | 0.5 | – | pF |
| G _{UM} | maximum unilateral power gain; note 1 | I _C = 40 mA; V _{CE} = 8 V; f = 900 MHz; T _{amb} = 25 °C | – | 16 | – | dB |
| | | I _C = 40 mA; V _{CE} = 8 V; f = 2 GHz; T _{amb} = 25 °C | – | 10 | – | dB |
| S ₂₁ ² | insertion power gain | I _C = 40 mA; V _{CE} = 8 V; f = 900 MHz; T _{amb} = 25 °C | 14 | 15 | – | dB |
| F | noise figure | Γ _s = Γ _{opt} ; I _C = 10 mA; V _{CE} = 8 V; f = 900 MHz | – | 1.3 | 1.8 | dB |
| | | Γ _s = Γ _{opt} ; I _C = 40 mA; V _{CE} = 8 V; f = 900 MHz | – | 1.9 | 2.4 | dB |
| | | Γ _s = Γ _{opt} ; I _C = 10 mA; V _{CE} = 8 V; f = 2 GHz | – | 2.1 | – | dB |
| P _{L1} | output power at 1 dB gain compression | I _C = 40 mA; V _{CE} = 8 V; f = 900 MHz; R _L = 50 Ω; T _{amb} = 25 °C | – | 21 | – | dBm |
| ITO | third order intercept point | note 2 | – | 34 | – | dBm |
| V _o | output voltage | note 3 | – | 500 | – | mV |
| d ₂ | second order intermodulation distortion | note 4 | – | –50 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming s₁₂ is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.
- I_C = 40 mA; V_{CE} = 8 V; R_L = 50 Ω; T_{amb} = 25 °C;
 - f_p = 900 MHz; f_q = 902 MHz; measured at f_(2p-q) = 898 MHz and f_(2q-p) = 904 MHz.
- d_{im} = –60 dB (DIN45004B); V_p = V_o; V_q = V_o – 6 dB; V_r = V_o – 6 dB; R_L = 75 Ω; V_{CE} = 8 V; I_C = 40 mA;
 - f_p = 795.25 MHz; f_q = 803.25 MHz; f_r = 805.25 MHz; measured at f_(p+q-r) = 793.25 MHz.
- I_C = 40 mA; V_{CE} = 8 V; V_o = 275 mV; R_L = 75 Ω; T_{amb} = 25 °C;
 - f_p = 250 MHz; f_q = 560 MHz; measured at f_(p+q) = 810 MHz.

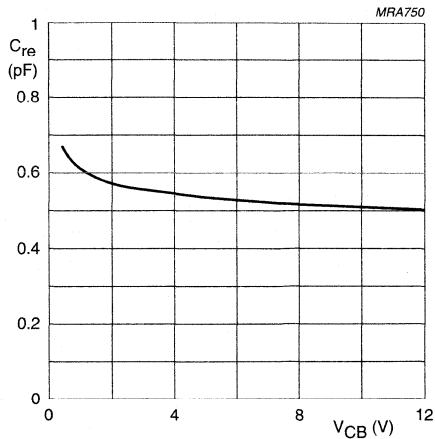
NPN 9 GHz wideband transistor

BFG540W
BFG540W/X; BFG540W/XR



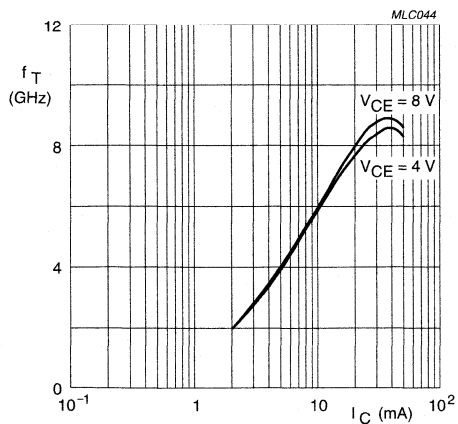
$V_{CE} = 8$ V.

Fig.4 DC current gain as a function of collector current; typical values.



$I_C = 0$; $f = 1$ MHz.

Fig.5 Feedback capacitance as a function of collector-base voltage; typical values.

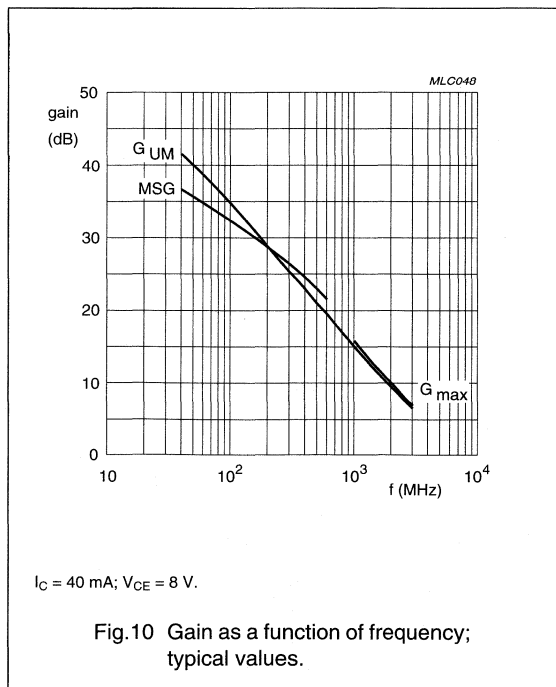
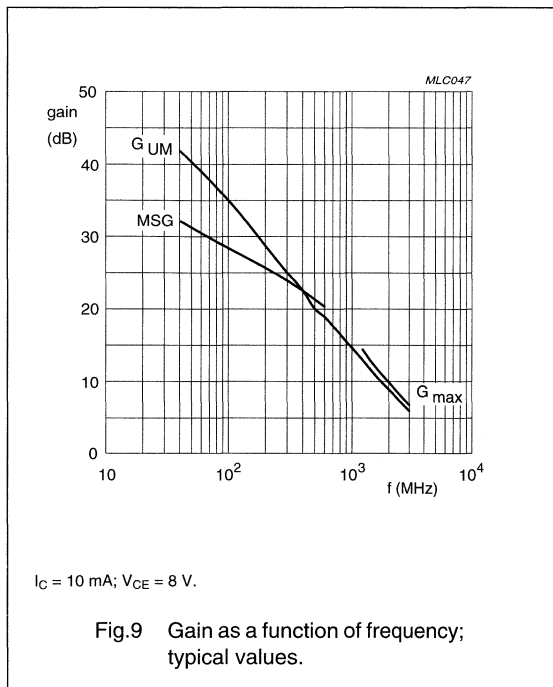
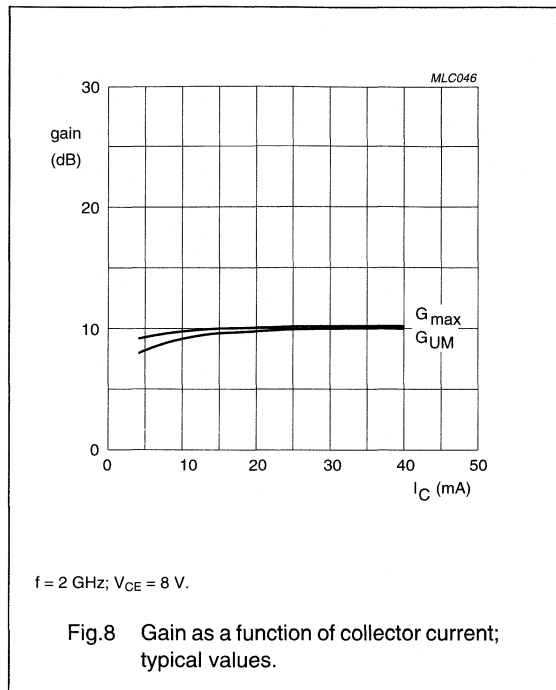
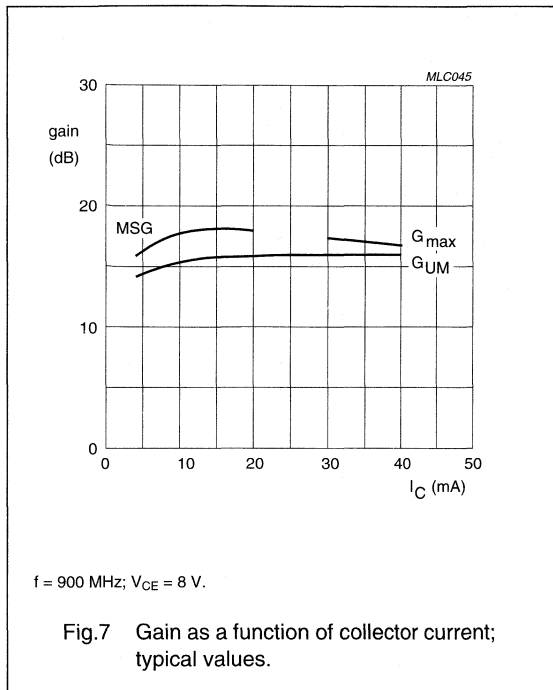


$f = 1$ GHz; $T_{amb} = 25$ °C.

Fig.6 Transition frequency as a function of collector current; typical values.

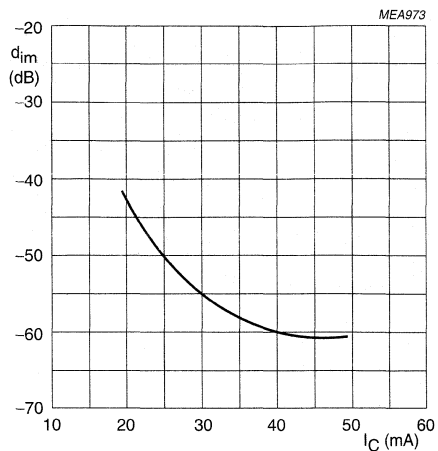
NPN 9 GHz wideband transistor

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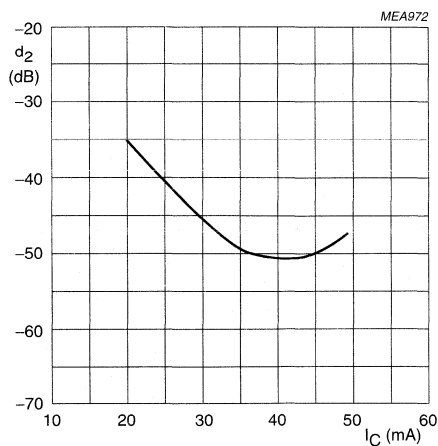
NPN 9 GHz wideband transistor

BFG540W
BFG540W/X; BFG540W/XR



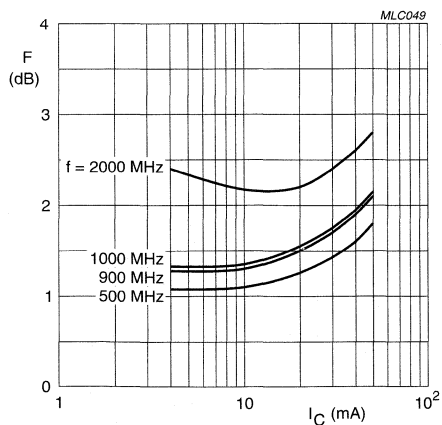
$V_o = 500 \text{ mV}$; $f_{(p+q-r)} = 793.25 \text{ MHz}$; $V_{CE} = 8 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$; $R_L = 75 \text{ } \Omega$.

Fig.11 Intermodulation distortion as a function of collector current; typical values.



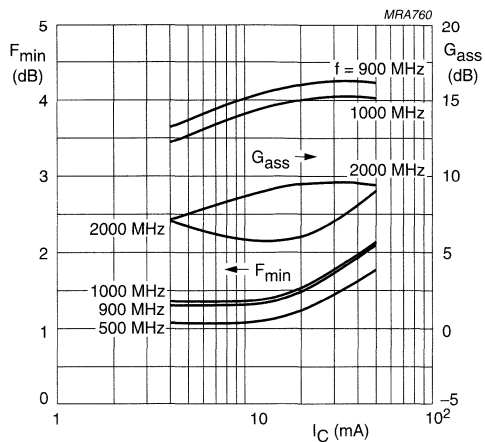
$V_o = 275 \text{ mV}$; $f_{(p+q)} = 810 \text{ MHz}$; $V_{CE} = 8 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$; $R_L = 75 \text{ } \Omega$.

Fig.12 Second order intermodulation distortion as a function of collector current; typical values.



$V_{CE} = 8 \text{ V}$.

Fig.13 Minimum noise figure as a function of collector current; typical values.

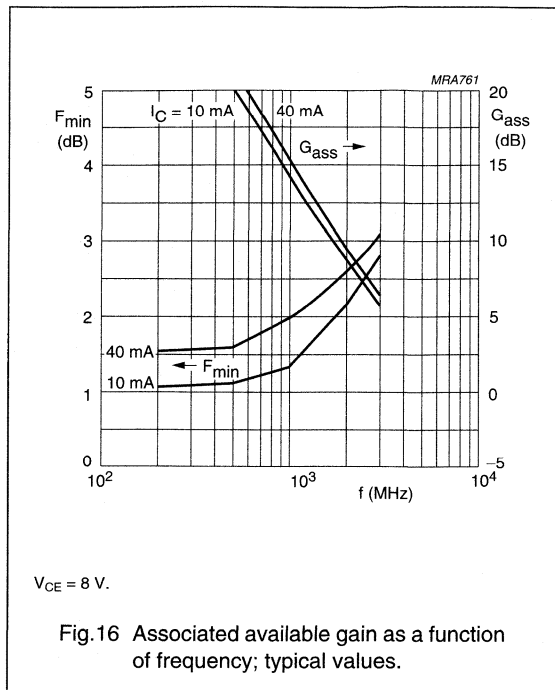
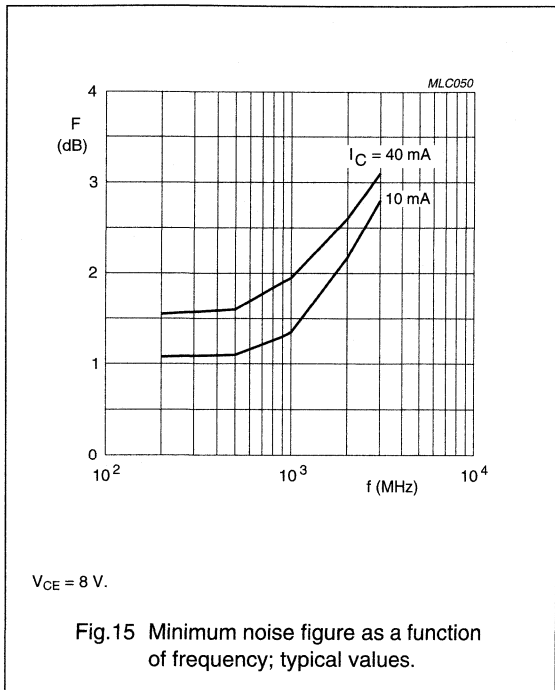


$V_{CE} = 8 \text{ V}$.

Fig.14 Associated available gain as a function of collector current; typical values.

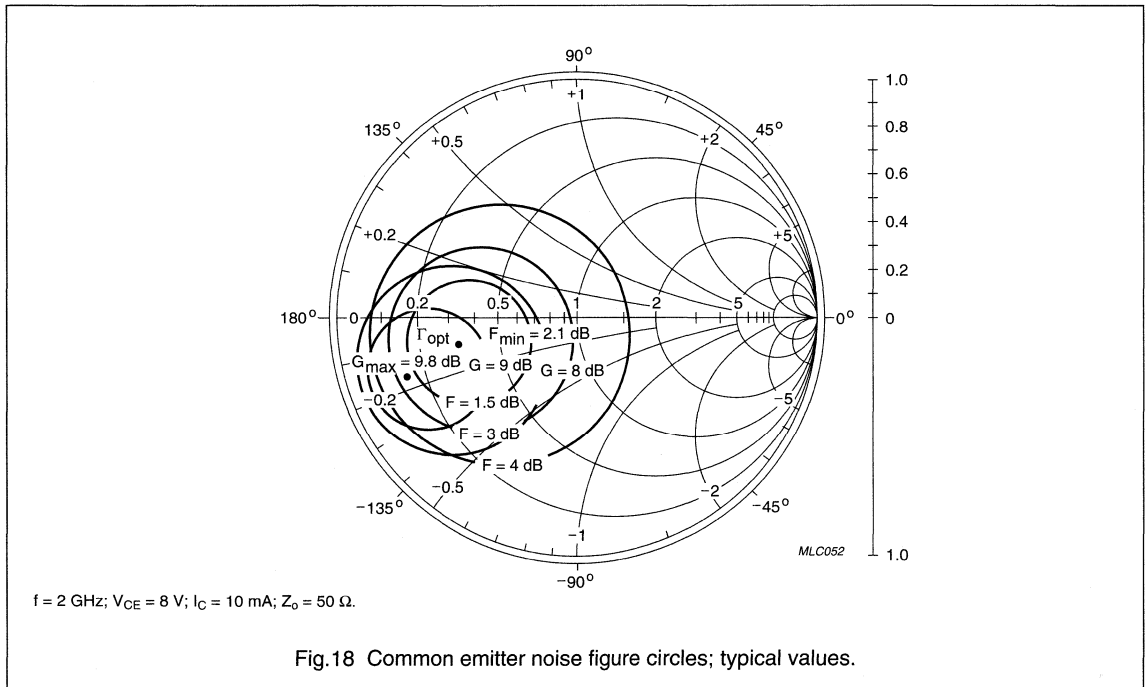
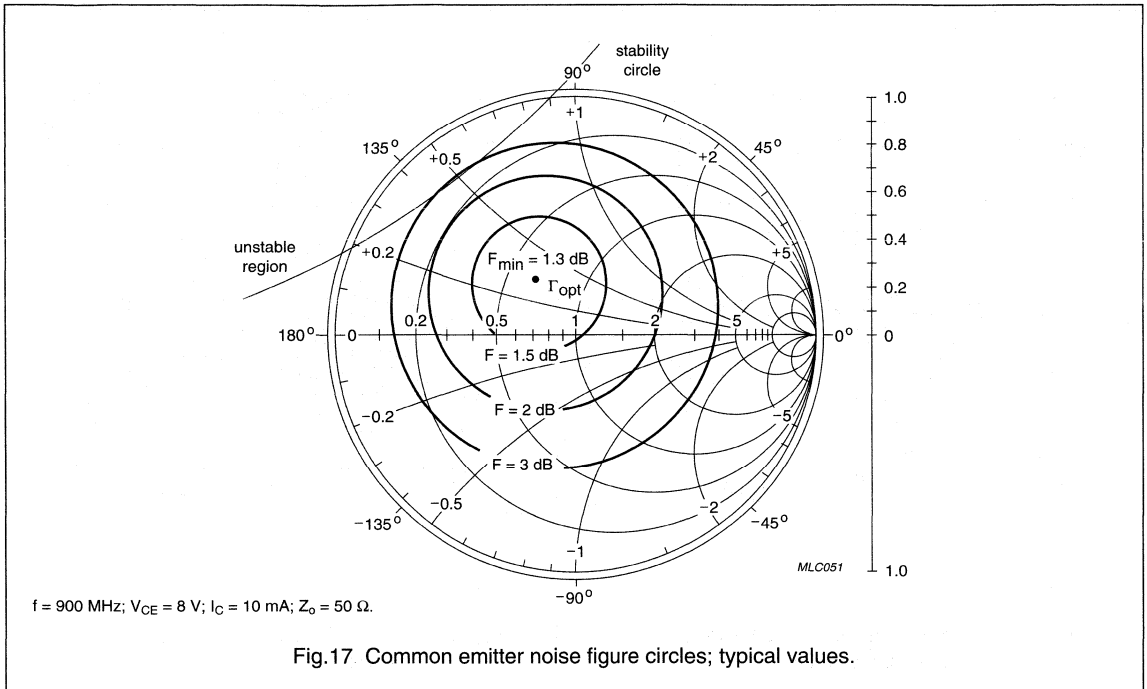
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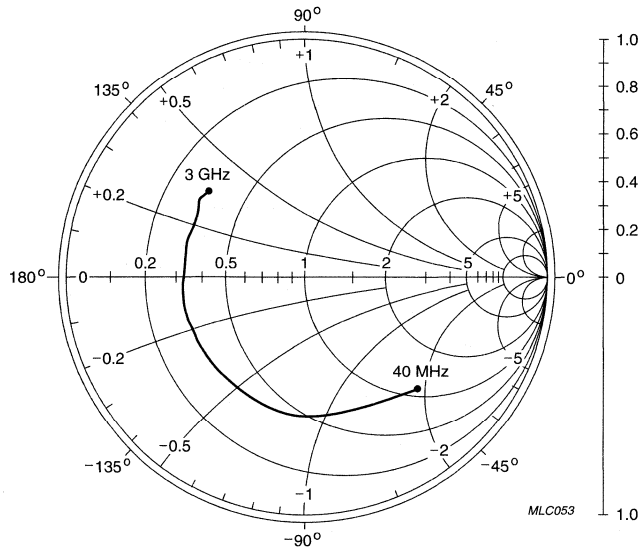
NPN 9 GHz wideband transistor

BFG540W
BFG540W/X; BFG540W/XR



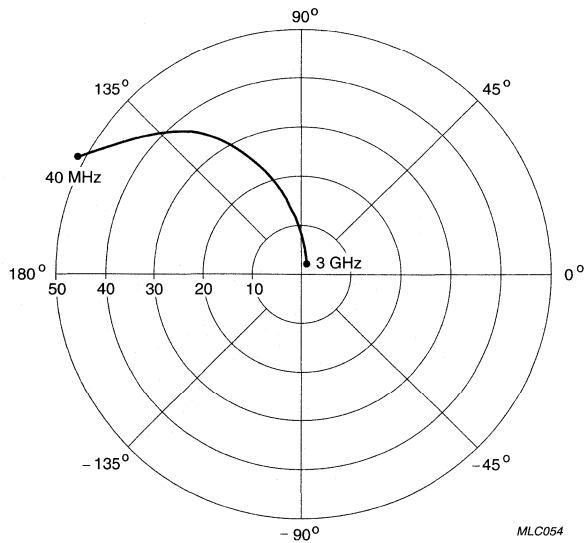
NPN 9 GHz wideband transistor

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BFG540W/X; BFG540W/XR



$V_{CE} = 8 \text{ V}; I_C = 40 \text{ mA}; Z_0 = 50 \Omega.$

Fig.19 Common emitter input reflection coefficient (s_{11}); typical values.

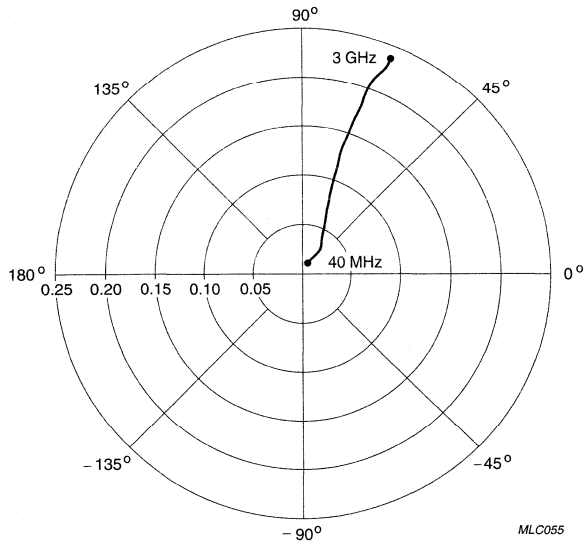


$V_{CE} = 8 \text{ V}; I_C = 40 \text{ mA}.$

Fig.20 Common emitter forward transmission coefficient (s_{21}); typical values.

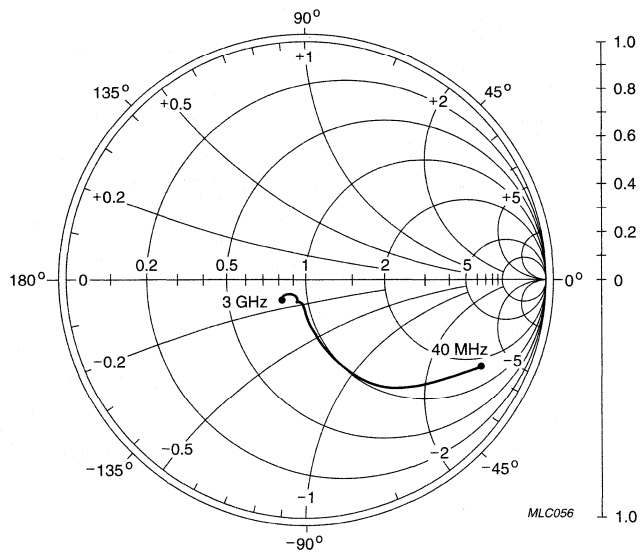
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$V_{CE} = 8\text{ V}; I_C = 40\text{ mA}$.

Fig.21 Common emitter reverse transmission coefficient (s_{12}); typical values.



$V_{CE} = 8\text{ V}; I_C = 40\text{ mA}; Z_0 = 50\ \Omega$.

Fig.22 Common emitter output reflection coefficient (s_{22}); typical values.

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BFG540W/X; BFG540W/XR

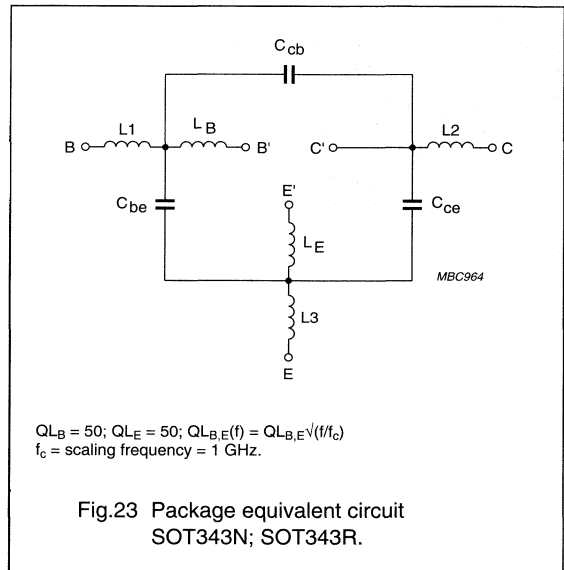
SPICE parameters for the BFG540W crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|------------|
| 1 | IS | 1.045 | fA |
| 2 | BF | 184.3 | – |
| 3 | NF | 0.981 | – |
| 4 | VAF | 41.69 | V |
| 5 | IKF | 10.00 | A |
| 6 | ISE | 232.4 | fA |
| 7 | NE | 2.028 | – |
| 8 | BR | 43.99 | – |
| 9 | NR | 0.992 | – |
| 10 | VAR | 2.097 | V |
| 11 | IKR | 166.2 | mA |
| 12 | ISC | 129.8 | aA |
| 13 | NC | 1.064 | – |
| 14 | RB | 5.000 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 5.000 | Ω |
| 17 | RE | 353.5 | m Ω |
| 18 | RC | 1.340 | Ω |
| 19 (1) | XTB | 0.000 | – |
| 20 (1) | EG | 1.110 | eV |
| 21 (1) | XTI | 3.000 | – |
| 22 | CJE | 1.978 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.332 | – |
| 25 | TF | 7.457 | ps |
| 26 | XTF | 11.40 | – |
| 27 | VTF | 3.158 | V |
| 28 | ITF | 156.9 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 793.7 | fF |
| 31 | VJC | 185.5 | mV |
| 32 | MJC | 0.084 | – |
| 33 | XCJC | 0.150 | – |
| 34 | TR | 1.598 | ns |
| 35 (1) | CJS | 0.000 | F |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|------|
| 36 (1) | VJS | 750.0 | mV |
| 37 (1) | MJS | 0.000 | – |
| 38 | FC | 0.814 | – |

Note

1. These parameters have not been extracted, the default values are shown.

**List of components** (see Fig.23).

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 70 | fF |
| C_{cb} | 50 | fF |
| C_{ce} | 115 | fF |
| L1 | 0.34 | nH |
| L2 | 0.10 | nH |
| L3 | 0.25 | nH |
| L_B | 0.40 | nH |
| L_E | 0.40 | nH |

NPN 9 GHz wideband transistor**BFG541****FEATURES**

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

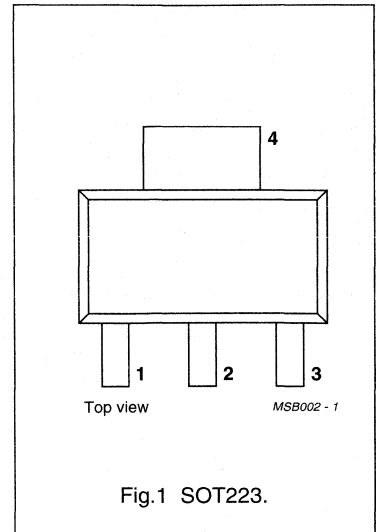
DESCRIPTION

NPN silicon planar epitaxial transistor, intended for wideband applications in the GHz range, such as analog and digital cellular telephones, cordless telephones (CT1, CT2, DECT, etc.), radar detectors, satellite TV tuners (SATV), MATV/CATV amplifiers and repeater amplifiers in fibre-optic systems.

The transistors are mounted in a plastic SOT223 envelope.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



NPN 9 GHz wideband transistor

BFG541

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|---------------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | DC collector current | | – | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 140\text{ °C}$; note 1 | – | – | 650 | mW |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_j = 25\text{ °C}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| f_T | transition frequency | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| | | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 13 | 14 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.3 | 1.8 | dB |
| PL_1 | output power at 1 dB gain compression | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 21 | – | dBm |
| ITO | third order intercept point | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 34 | – | dBm |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 140\text{ °C}$; note 1 | – | 650 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 140\text{ °C}$; note 1 | 55 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFG541

CHARACTERISTICS

 $T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 8\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 2 | – | pF |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 1 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| f_T | transition frequency | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| | | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 13 | 14 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.3 | 1.8 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.9 | 2.4 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 2.1 | – | dB |
| PL_1 | output power at 1 dB gain compression | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 21 | – | dBm |
| ITO | third order intercept point | note 2 | – | 34 | – | dBm |
| V_o | output voltage | note 3 | – | 500 | – | mV |
| d_2 | second order intermodulation distortion | note 4 | – | –50 | – | dB |

Notes

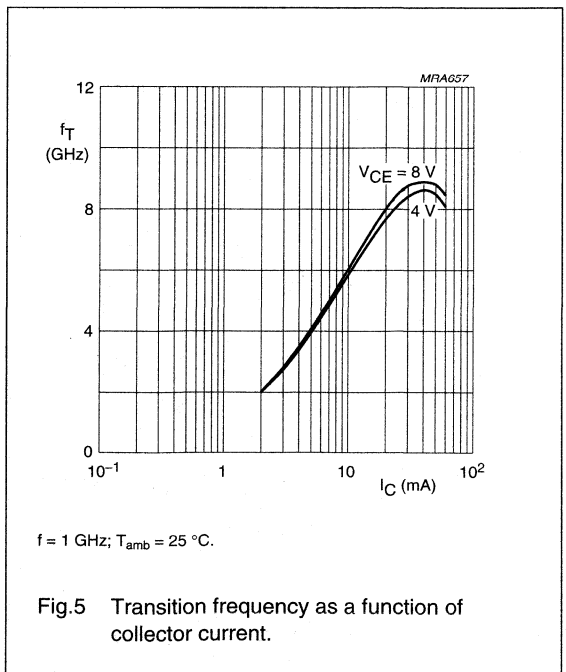
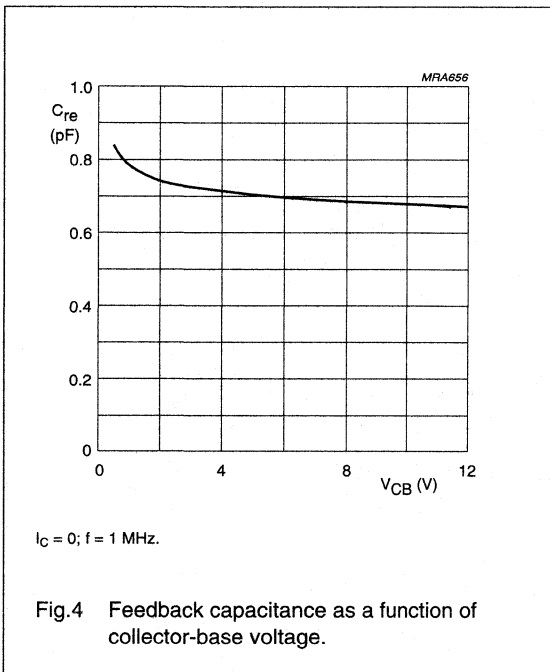
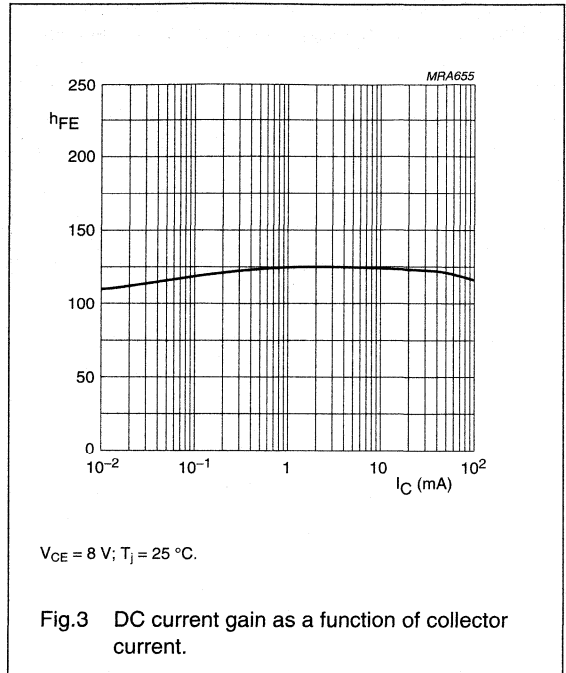
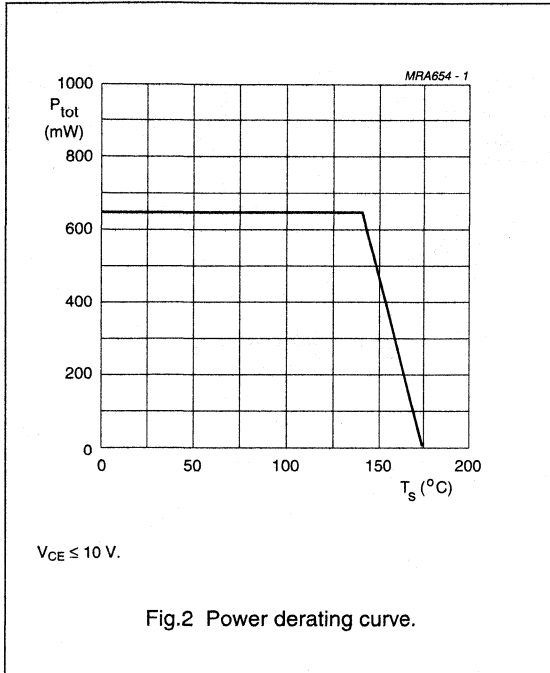
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

2. $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$;
 $f_p = 900\text{ MHz}$; $f_q = 902\text{ MHz}$;
measured at $f_{(2p-q)} = 898\text{ MHz}$ and at $f_{(2p-q)} = 904\text{ MHz}$.
3. $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $Z_L = Z_s = 75\text{ }\Omega$; $T_{amb} = 25\text{ °C}$;
 $V_p = V_o$; $V_q = V_o - 6\text{ dB}$; $V_r = V_o - 6\text{ dB}$;
 $f_p = 795.25\text{ MHz}$; $f_q = 803.25\text{ MHz}$; $f_r = 805.25\text{ MHz}$;
measured at $f_{(p+q-r)} = 793.25\text{ MHz}$
4. $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $V_o = 325\text{ mV}$; $T_{amb} = 25\text{ °C}$;
 $f_p = 250\text{ MHz}$; $f_q = 560\text{ MHz}$;
measured at $f_{(p+q)} = 810\text{ MHz}$

NPN 9 GHz wideband transistor

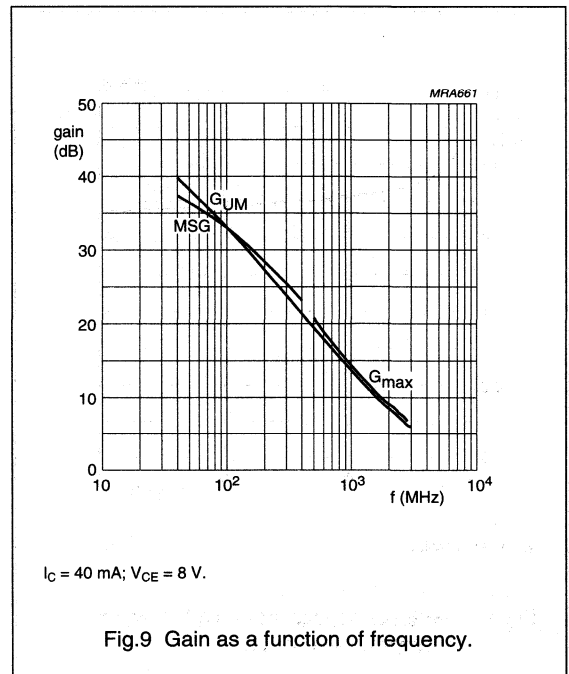
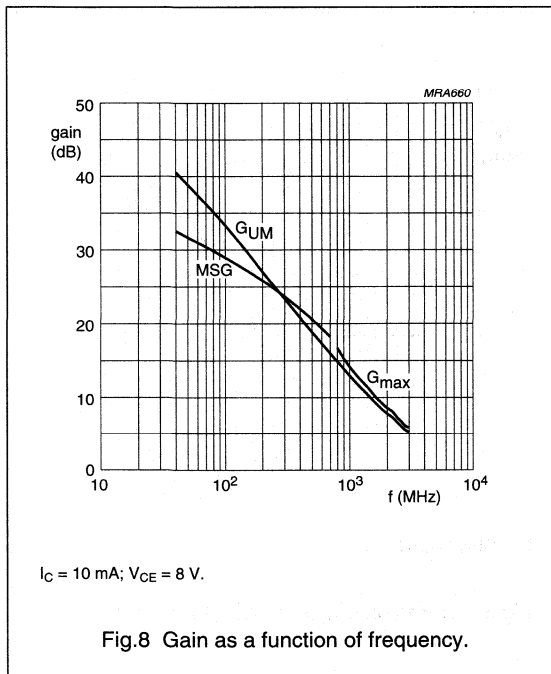
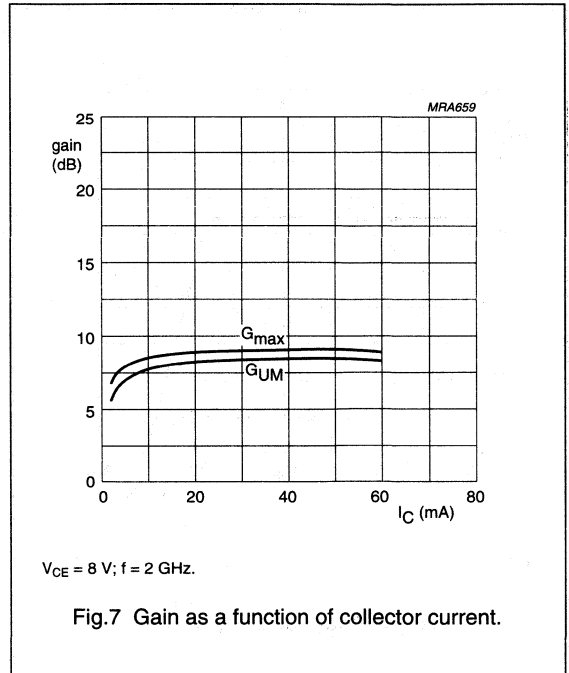
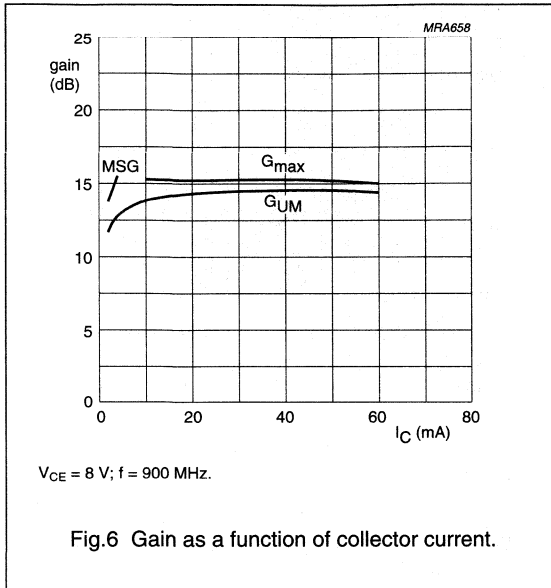
BFG541



NPN 9 GHz wideband transistor

BFG541

In Figs 6 to 9, G_{UM} = maximum power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



NPN 9 GHz wideband transistor

BFG541

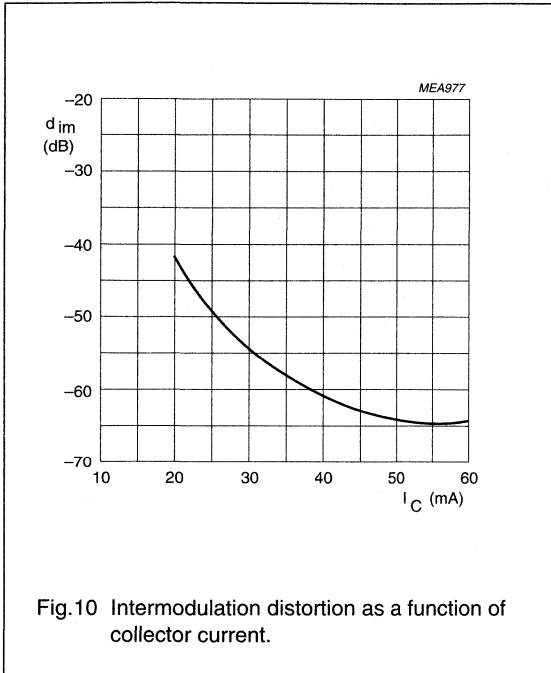


Fig.10 Intermodulation distortion as a function of collector current.

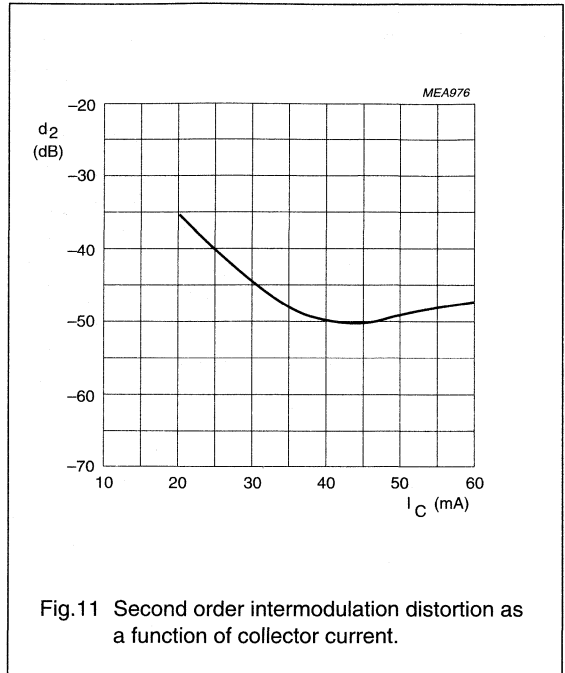
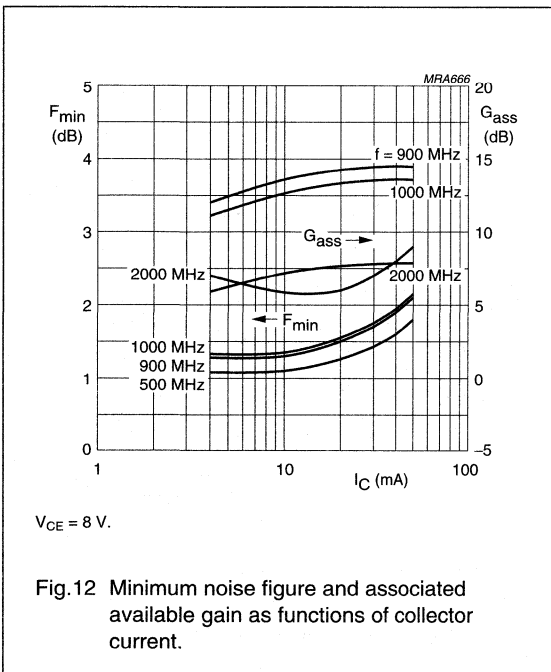
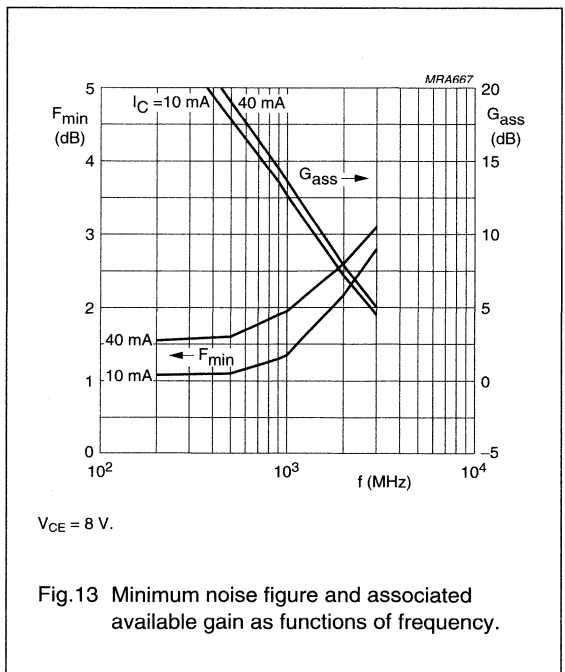


Fig.11 Second order intermodulation distortion as a function of collector current.



$V_{CE} = 8$ V.

Fig.12 Minimum noise figure and associated available gain as functions of collector current.

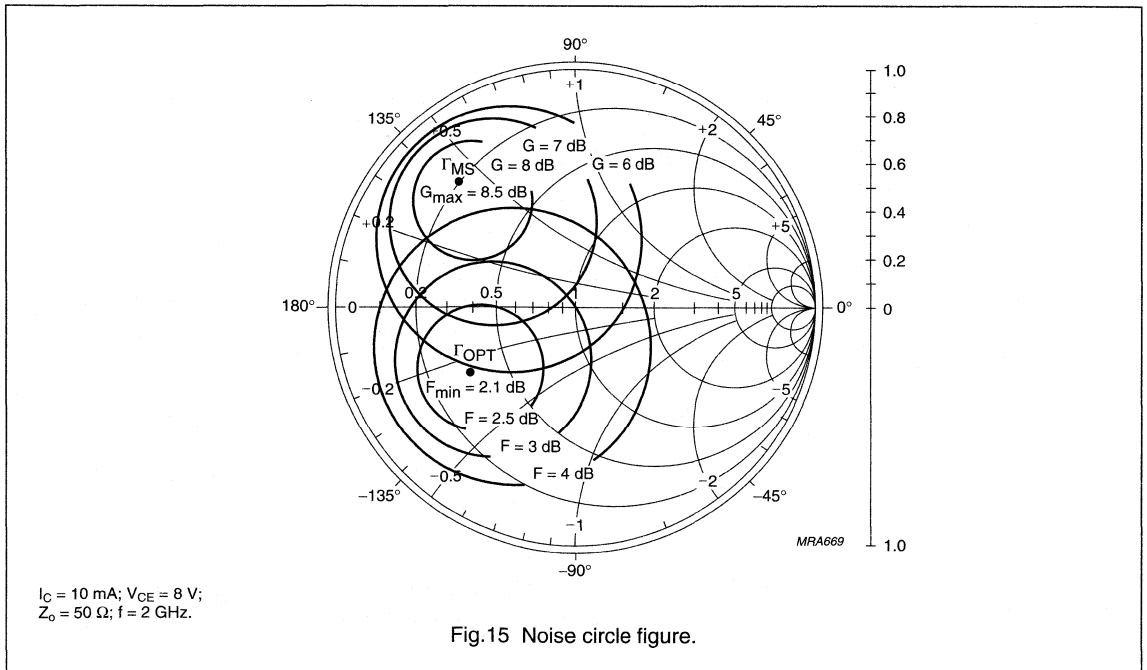
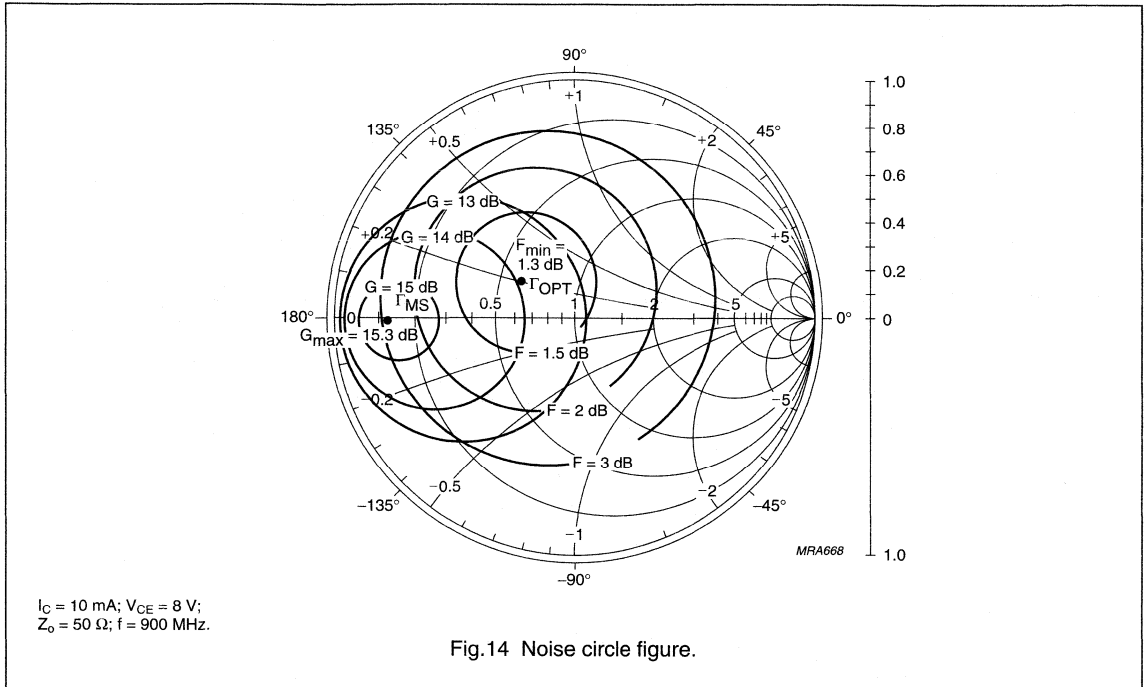


$V_{CE} = 8$ V.

Fig.13 Minimum noise figure and associated available gain as functions of frequency.

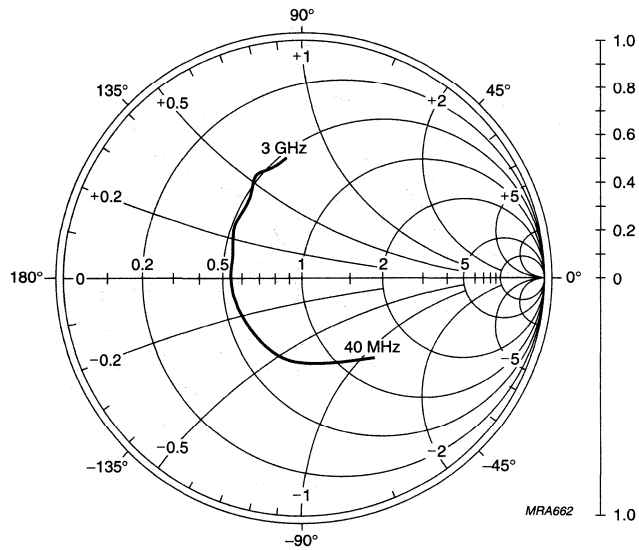
NPN 9 GHz wideband transistor

BFG541



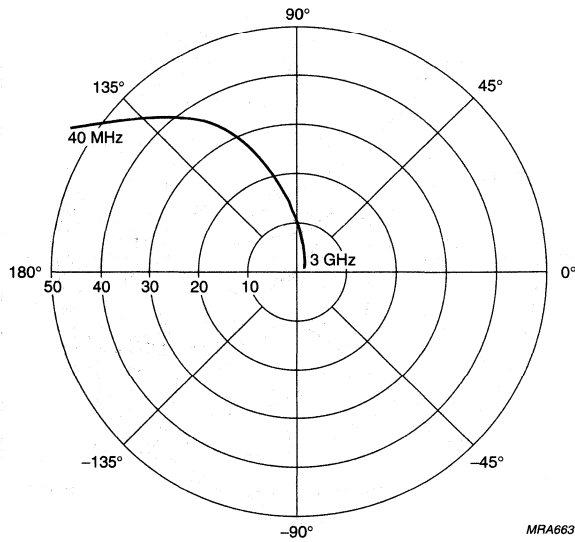
NPN 9 GHz wideband transistor

BFG541



$I_C = 40 \text{ mA}$; $V_{CE} = 8 \text{ V}$.
 $Z_o = 50 \Omega$.

Fig.16 Common emitter input reflection coefficient (S_{11}).

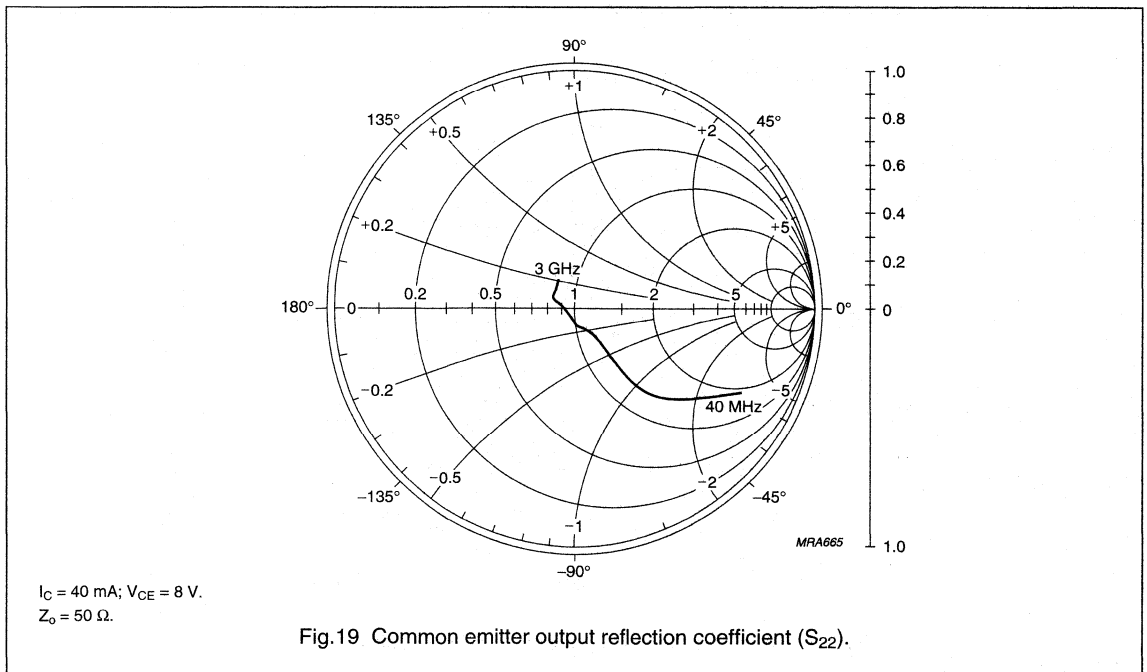
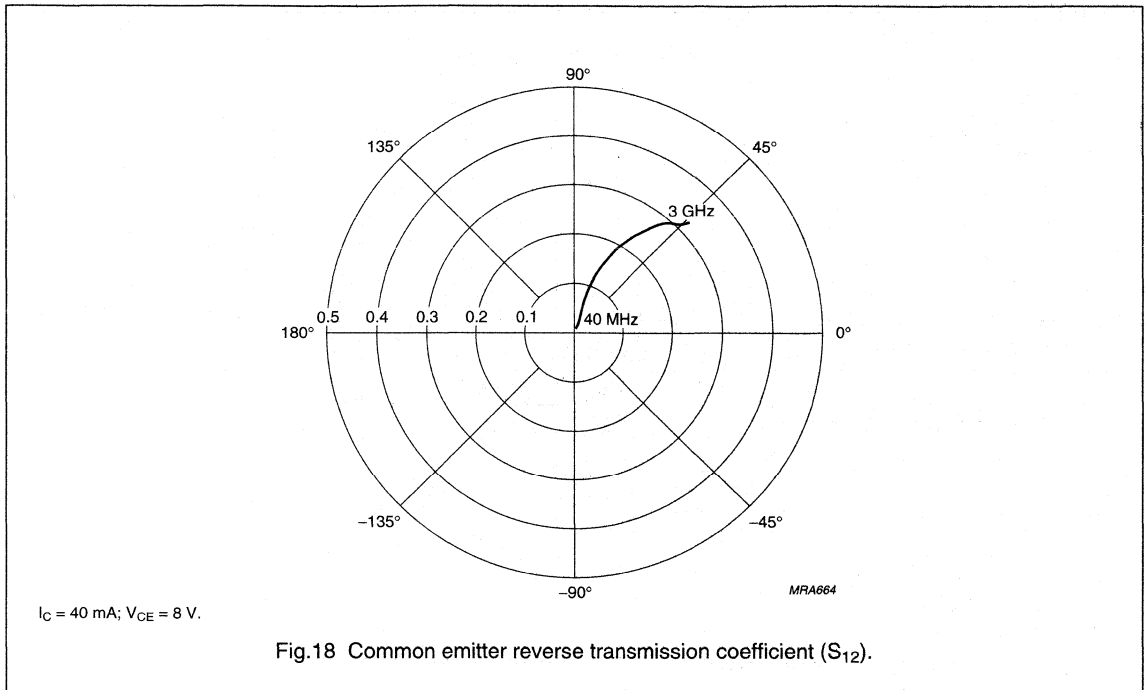


$I_C = 40 \text{ mA}$; $V_{CE} = 8 \text{ V}$.

Fig.17 Common emitter forward transmission coefficient (S_{21}).

NPN 9 GHz wideband transistor

BFG541



NPN 5 GHz wideband transistor

BFG590; BFG590/X;
BFG590/XR

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

APPLICATIONS

They are intended for applications in the GHz range such as MATV/CATV amplifiers and RF communications subscriber equipment. They are ideally suitable for use in class-A, (A)B and C amplifiers with either pulsed or continuous drive.

DESCRIPTION

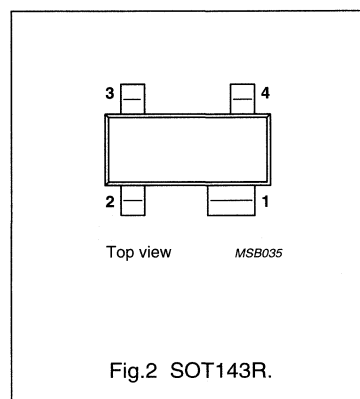
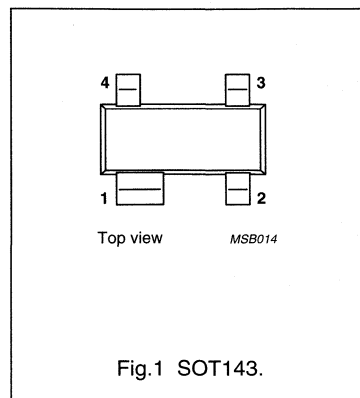
NPN silicon planar epitaxial transistors encapsulated in plastic, 4-pin dual-emitter SOT143 and SOT143R packages.

MARKING

| TYPE NUMBER | CODE |
|-------------|------|
| BFG590 | N38 |
| BFG590/X | N44 |
| BFG590/XR | N50 |

PINNING

| PIN | DESCRIPTION |
|------------------------------|-------------|
| BFG590 (see Fig.1) | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG590/X (see Fig.1) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG590/XR (see Fig.2) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | collector current (DC) | | – | – | 200 | mA |
| P_{tot} | total power dissipation | up to $T_s = 60\text{ °C}$ | – | – | 400 | mW |
| h_{FE} | DC current gain | $I_C = 35\text{ mA}$; $V_{CE} = 8\text{ V}$ | 50 | 90 | 280 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| f_T | transition frequency | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 1\text{ GHz}$ | – | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 11 | – | dB |

NPN 5 GHz wideband transistor

BFG590; BFG590/X;
BFG590/XR

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

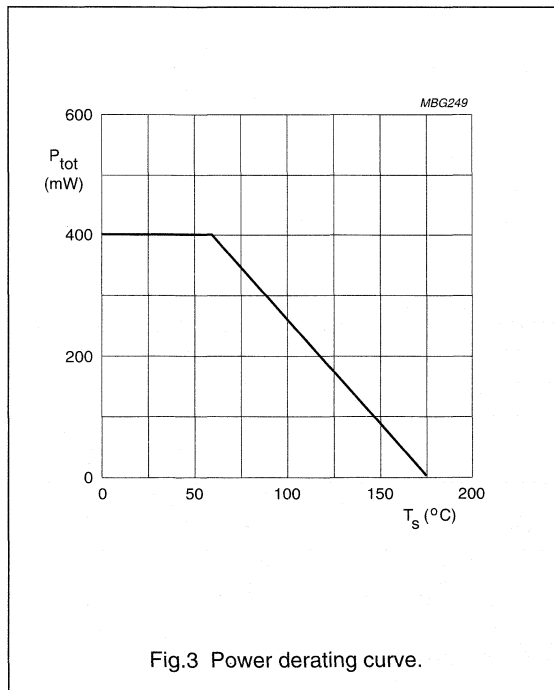
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | - | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | - | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | - | 3 | V |
| I_C | collector current (DC) | | - | 200 | mA |
| P_{tot} | total power dissipation | up to $T_s = 60\text{ }^\circ\text{C}$; see Fig.3; note 1 | - | 400 | mW |
| T_{stg} | storage temperature | | -65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | - | 175 | $^\circ\text{C}$ |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 60\text{ }^\circ\text{C}$; note 1 | 290 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.



NPN 5 GHz wideband transistor

BFG590; BFG590/X;
BFG590/XR**CHARACTERISTICS** $T_j = 25\text{ °C}$ (unless otherwise specified).

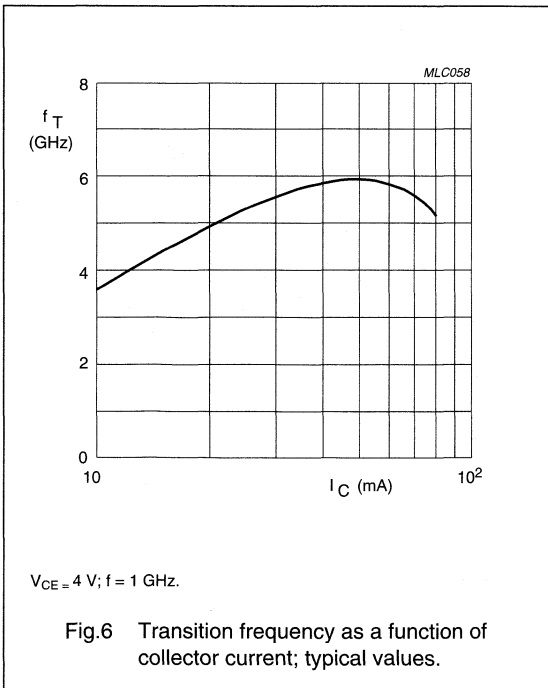
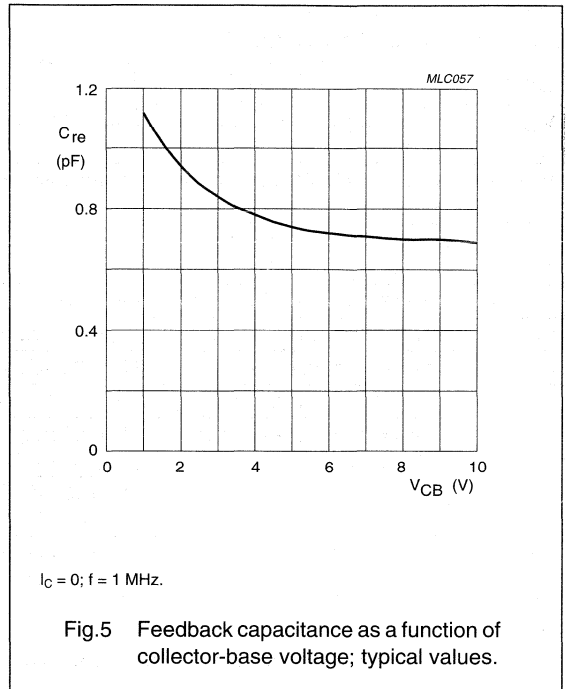
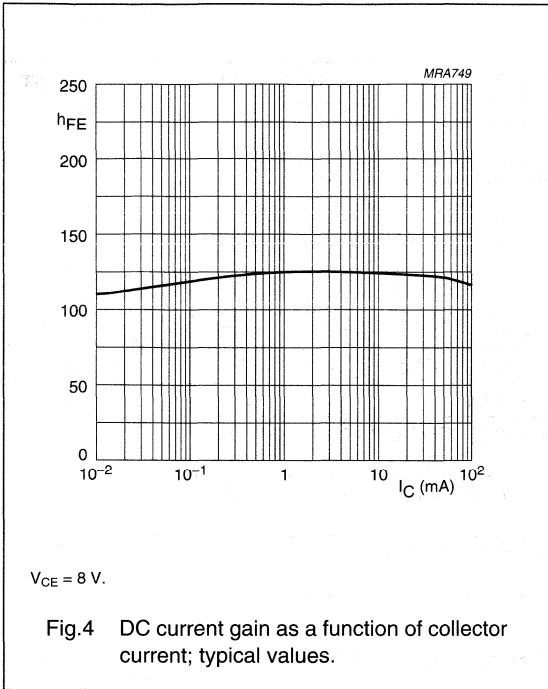
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---------------------------------------|---|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 0.1\text{ mA}$; $I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 10\text{ mA}$; $I_B = 0$ | 15 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.1\text{ mA}$; $I_C = 0$ | 3 | – | – | V |
| I_{CBO} | collector-base leakage current | $V_{CB} = 10\text{ V}$; $I_E = 0$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 70\text{ mA}$; $V_{CE} = 8\text{ V}$ | 60 | 120 | 250 | |
| f_T | transition frequency | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 1\text{ GHz}$; | – | 5 | – | GHz |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| | | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 7.5 | – | dB |
| $ s_{21} ^2$ | insertion power gain | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 11 | – | dB |

Note

1. G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero and $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

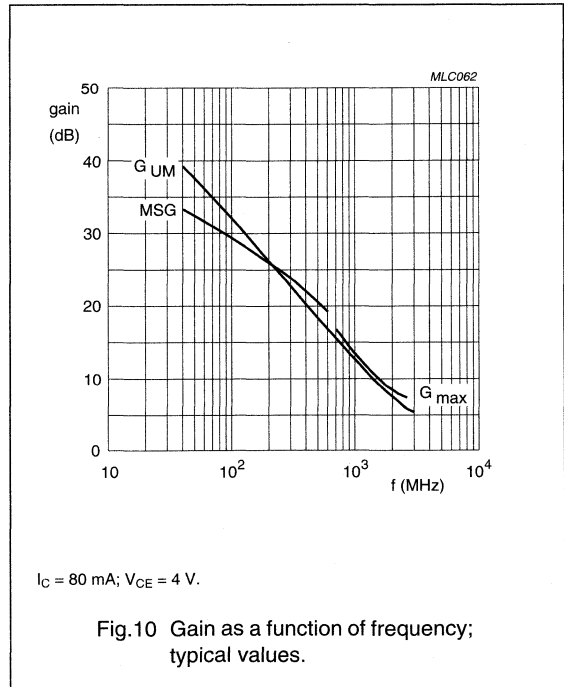
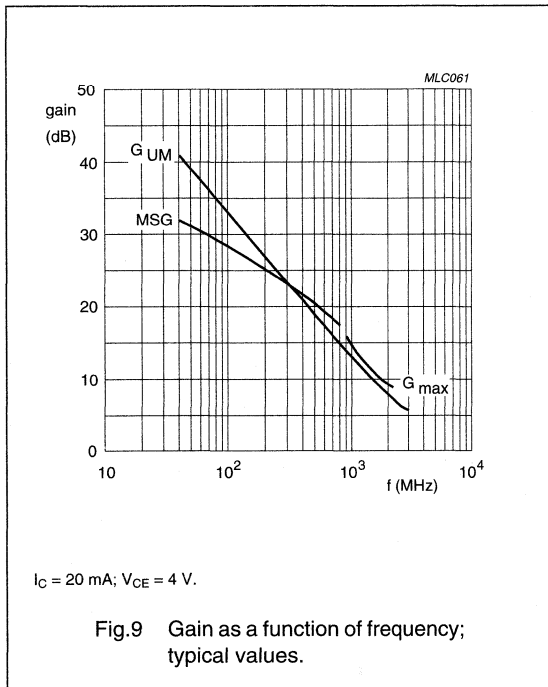
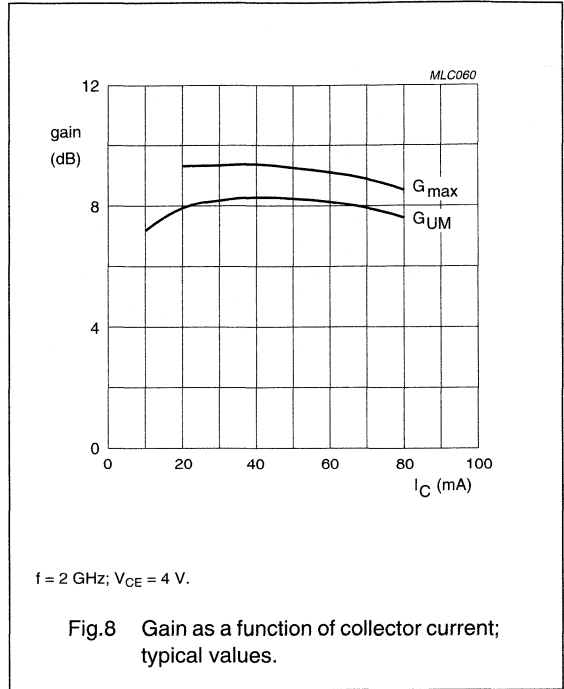
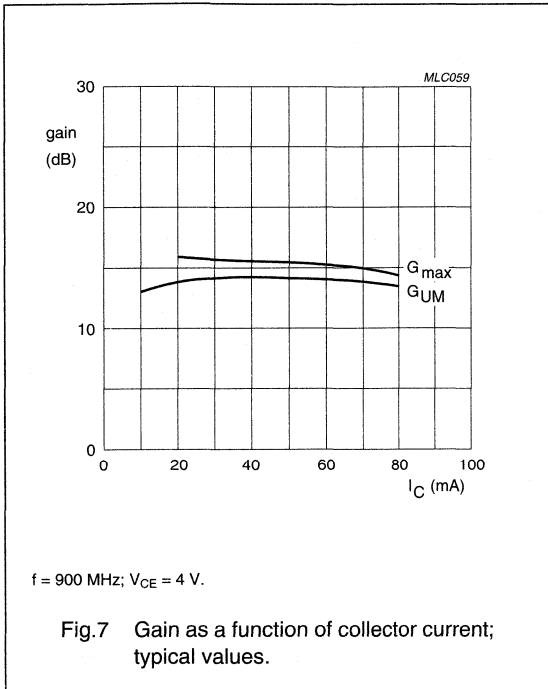
NPN 5 GHz wideband transistor

BFG590; BFG590/X;
BFG590/XR



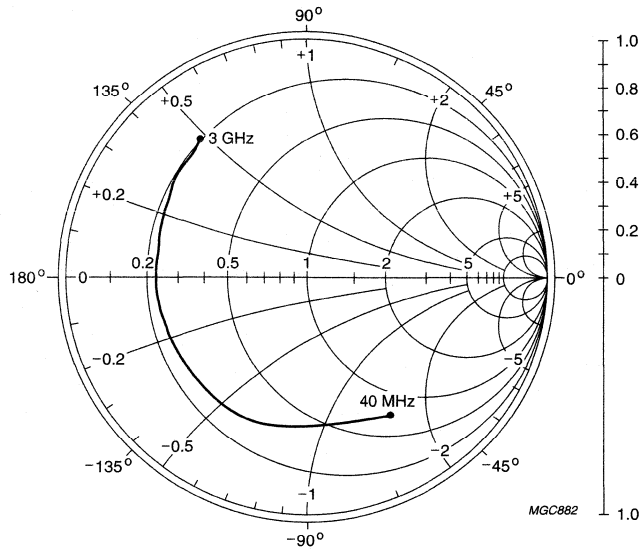
NPN 5 GHz wideband transistor

BFG590; BFG590/X;
BFG590/XR



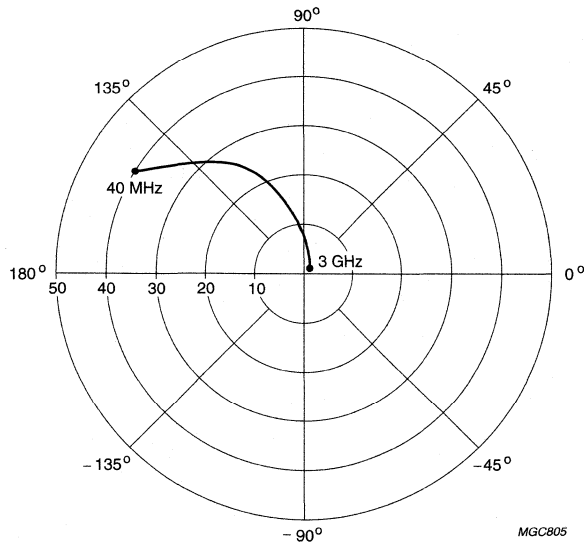
NPN 5 GHz wideband transistor

BFG590; BFG590/X;
BFG590/XR



$I_C = 80 \text{ mA}$; $V_{CE} = 4 \text{ V}$; $Z_o = 50 \Omega$.

Fig.11 Common emitter input reflection coefficient (s_{11}); typical values.

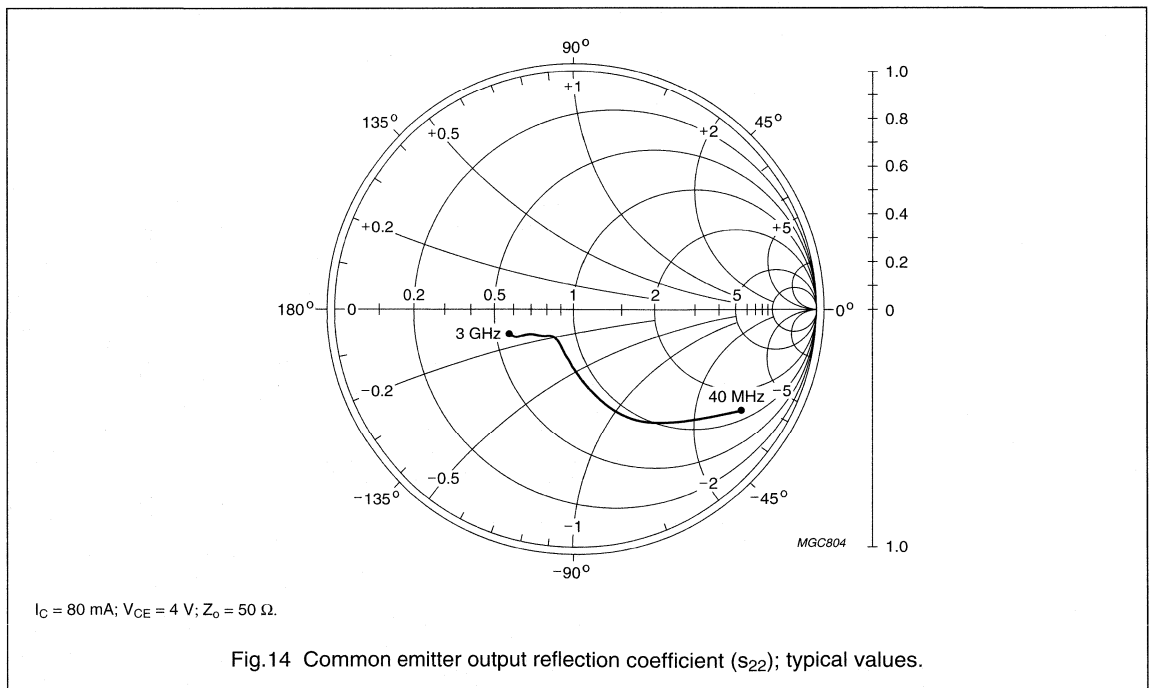
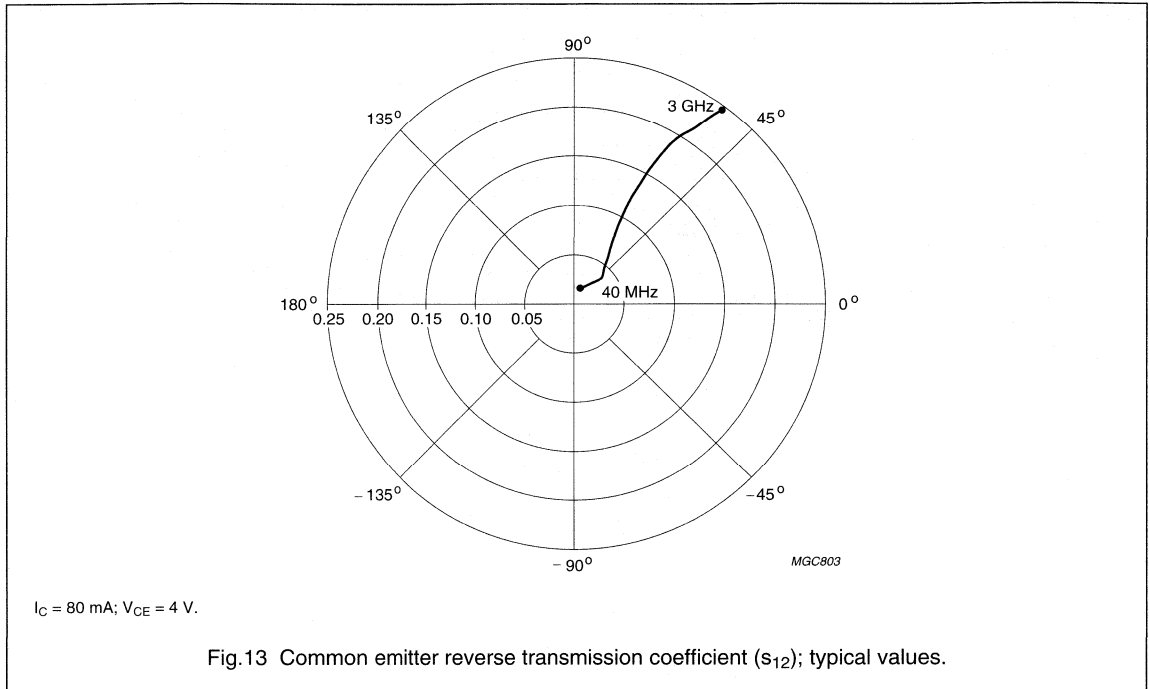


$I_C = 80 \text{ mA}$; $V_{CE} = 4 \text{ V}$.

Fig.12 Common emitter forward transmission coefficient (s_{21}); typical values.

NPN 5 GHz wideband transistor

BFG590; BFG590/X;
BFG590/XR



NPN 5 GHz wideband transistor

BFG590W
BFG590W/X; BFG590W/XR

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

APPLICATIONS

They are intended for wideband applications in the GHz range such as MATV/CATV amplifiers and RF communications subscriber equipment. They are ideally suitable for use in class-A, (A)B and C amplifiers with either pulsed or continuous drive.

DESCRIPTION

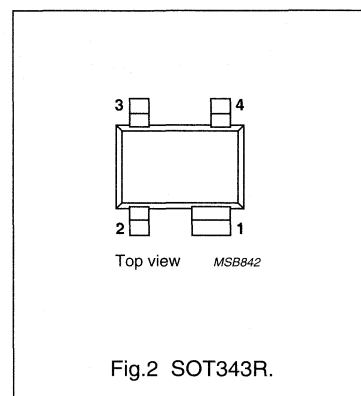
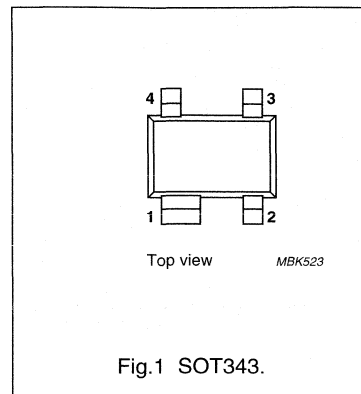
NPN silicon planar epitaxial transistors in plastic, 4-pin dual-emitter SOT343 and SOT343R packages.

MARKING

| TYPE NUMBER | CODE |
|-------------|------|
| BFG590W | T1 |
| BFG590W/X | T2 |
| BFG590W/XR | T3 |

PINNING

| PIN | DESCRIPTION |
|-------------------------------|-------------|
| BFG590W (see Fig.1) | |
| 1 | collector |
| 2 | base |
| 3 | emitter |
| 4 | emitter |
| BFG590W/X (see Fig.1) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |
| BFG590W/XR (see Fig.2) | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | collector current (DC) | | – | – | 200 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ °C}$ | – | – | 500 | mW |
| h_{FE} | DC current gain | $I_C = 70\text{ mA}$; $V_{CE} = 8\text{ V}$ | 60 | 90 | 250 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| f_T | transition frequency | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 80\text{ mA}$; $V_{CE} = 4\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 11 | – | dB |

NPN 5 GHz wideband transistor

BFG590W
BFG590W/X; BFG590W/XR

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| I_C | collector current (DC) | | – | 200 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ }^\circ\text{C}$; see Fig.3; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 175 | $^\circ\text{C}$ |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 85\text{ }^\circ\text{C}$; note 1 | 180 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.

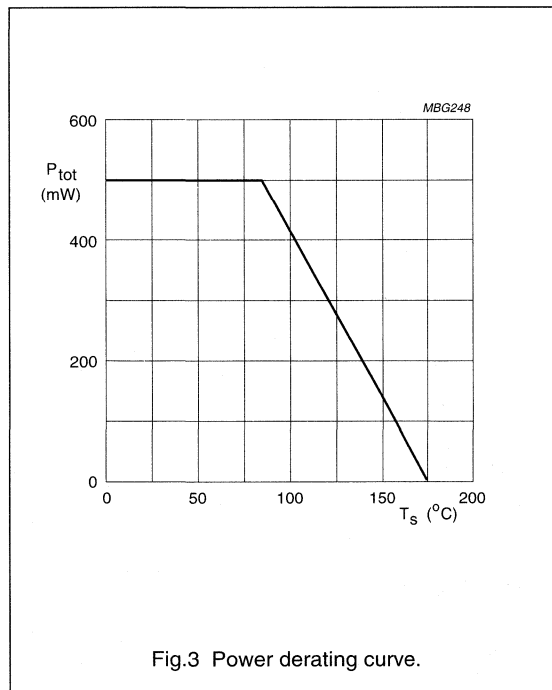


Fig.3 Power derating curve.

NPN 5 GHz wideband transistor

BFG590W
BFG590W/X; BFG590W/XR**CHARACTERISTICS**T_j = 25 °C (unless otherwise specified).

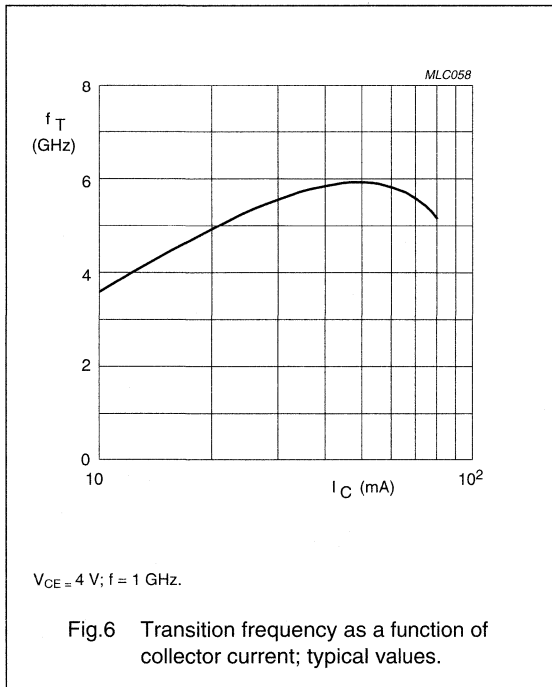
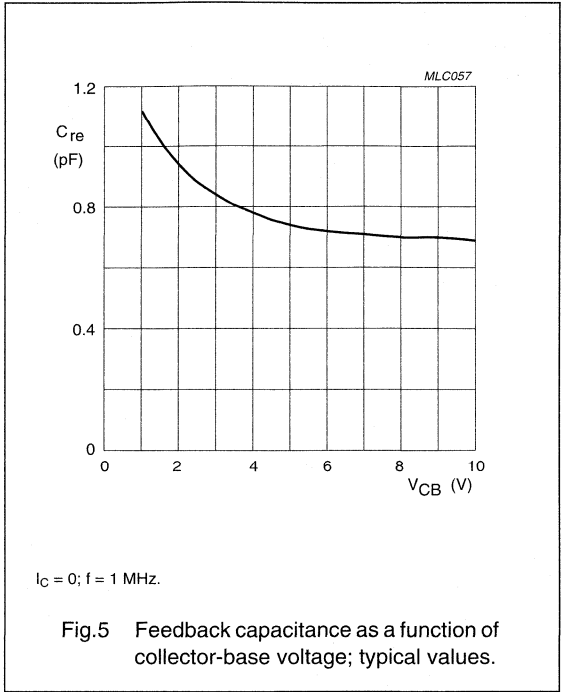
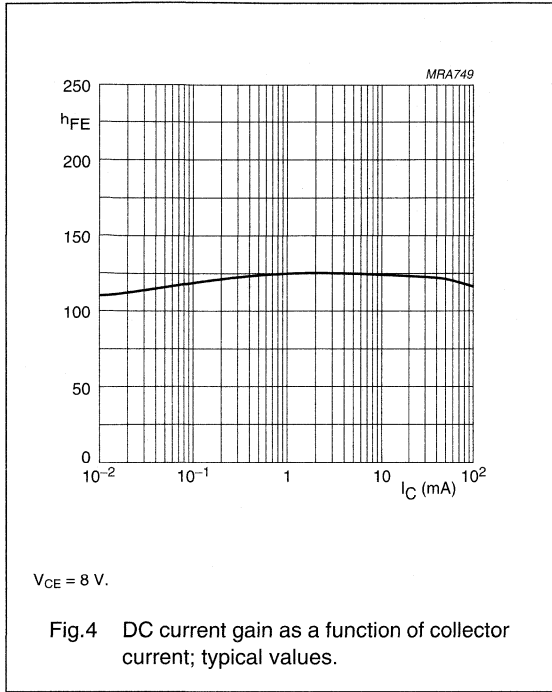
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------------------------|---------------------------------------|--|------|------|------|------|
| V _{(BR)CBO} | collector-base breakdown voltage | open emitter; I _C = 0.1 mA; I _E = 0 | 20 | – | – | V |
| V _{(BR)CEO} | collector-emitter breakdown voltage | open base; I _C = 10 mA; I _B = 0 | 15 | – | – | V |
| V _{(BR)EBO} | emitter-base breakdown voltage | open collector; I _E = 0.1 mA; I _C = 0 | 3 | – | – | V |
| I _{CBO} | collector cut-off current | V _{CB} = 10 V; I _E = 0 | – | – | 100 | nA |
| h _{FE} | DC current gain | I _C = 70 mA; V _{CE} = 8 V | 60 | 90 | 250 | |
| f _T | transition frequency | I _C = 80 mA; V _{CE} = 4 V; f = 1 GHz; T _{amb} = 25 °C | – | 5 | – | GHz |
| C _{re} | feedback capacitance | I _C = 0; V _{CB} = 8 V; f = 1 MHz | – | 0.7 | – | pF |
| G _{UM} | maximum unilateral power gain; note 1 | I _C = 80 mA; V _{CE} = 4 V; f = 900 MHz; T _{amb} = 25 °C | – | 13 | – | dB |
| | | I _C = 80 mA; V _{CE} = 4 V; f = 2 GHz; T _{amb} = 25 °C | – | 7.5 | – | dB |
| s ₂₁ ² | insertion power gain | I _C = 80 mA; V _{CE} = 4 V; f = 1 GHz; T _{amb} = 25 °C | – | 11 | – | dB |
| P _{L1} | output power at 1 dB gain compression | I _C = 80 mA; V _{CE} = 5 V; f = 900 MHz; R _L = 50 Ω; T _{amb} = 25 °C | – | 21 | – | dBm |

Notes

1. G_{UM} is the maximum unilateral power gain, assuming s₁₂ is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

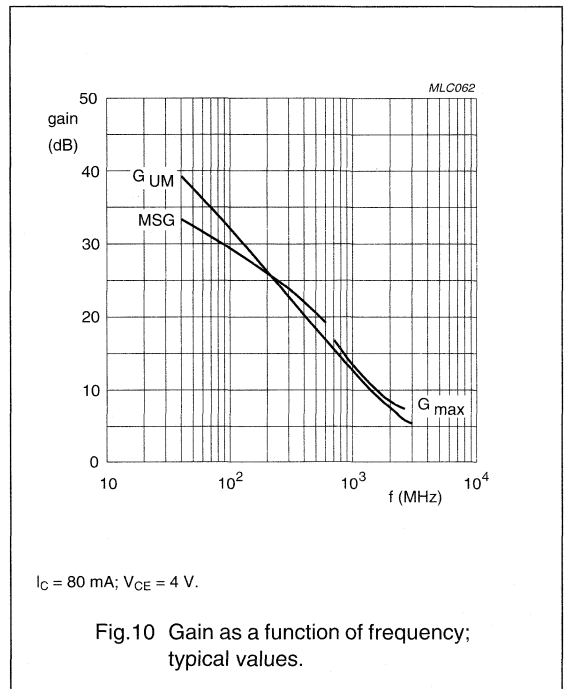
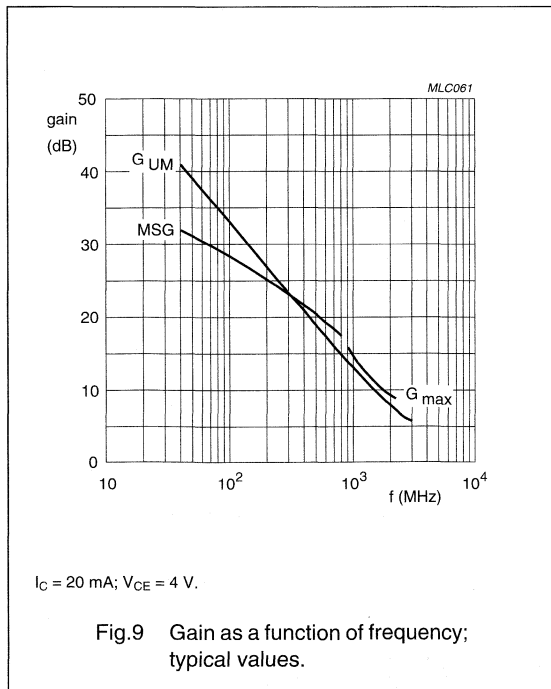
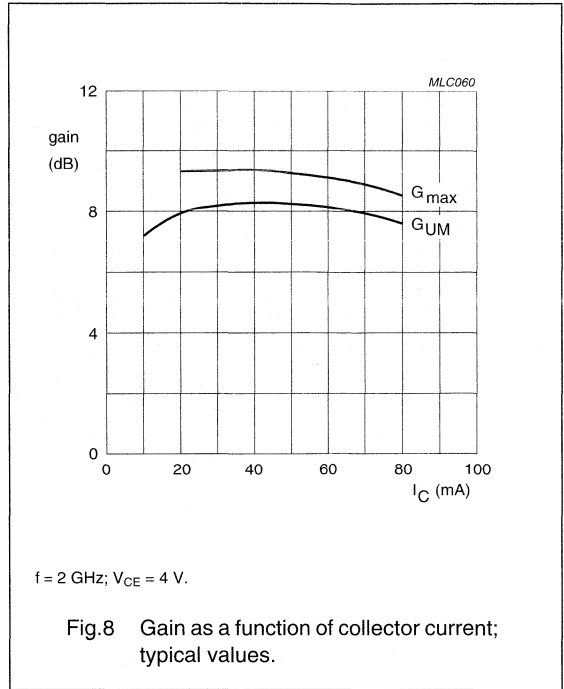
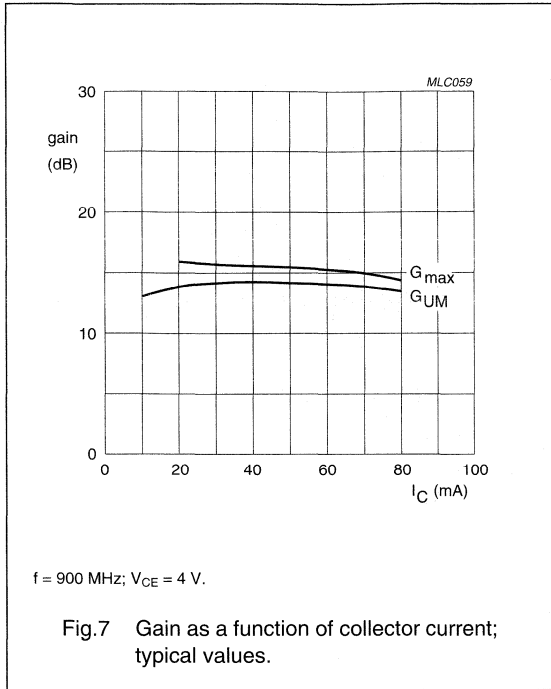
NPN 5 GHz wideband transistor

BFG590W
BFG590W/X; BFG590W/XR



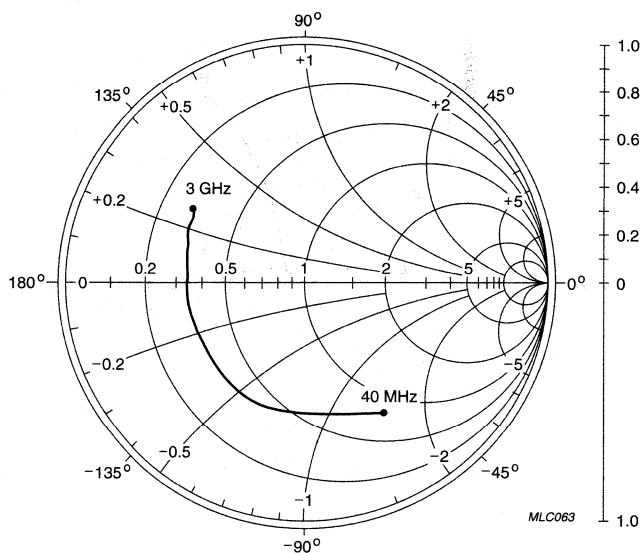
NPN 5 GHz wideband transistor

BFG590W
BFG590W/X; BFG590W/XR



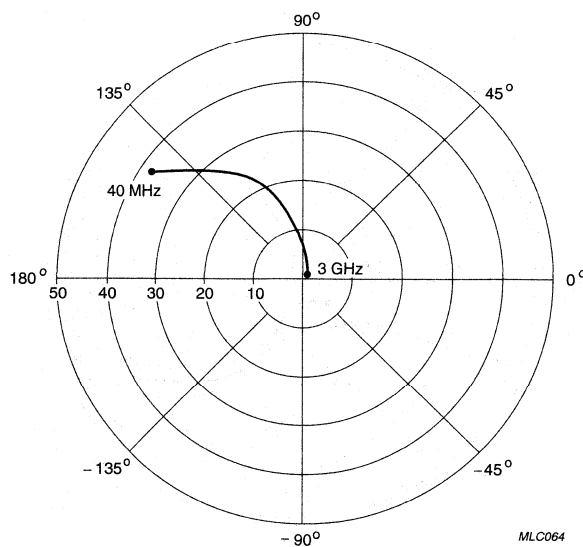
NPN 5 GHz wideband transistor

BFG590W
BFG590W/X; BFG590W/XR



$I_C = 80 \text{ mA}$; $V_{CE} = 4 \text{ V}$; $Z_o = 50 \Omega$.

Fig.11 Common emitter input reflection coefficient (s_{11}); typical values.

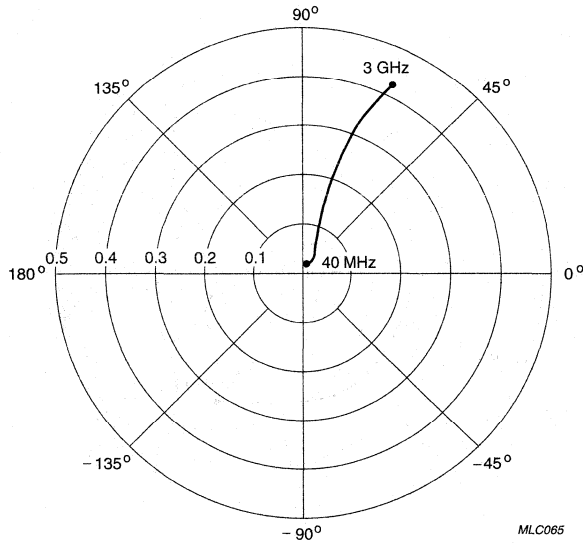


$I_C = 80 \text{ mA}$; $V_{CE} = 4 \text{ V}$.

Fig.12 Common emitter forward transmission coefficient (s_{21}); typical values.

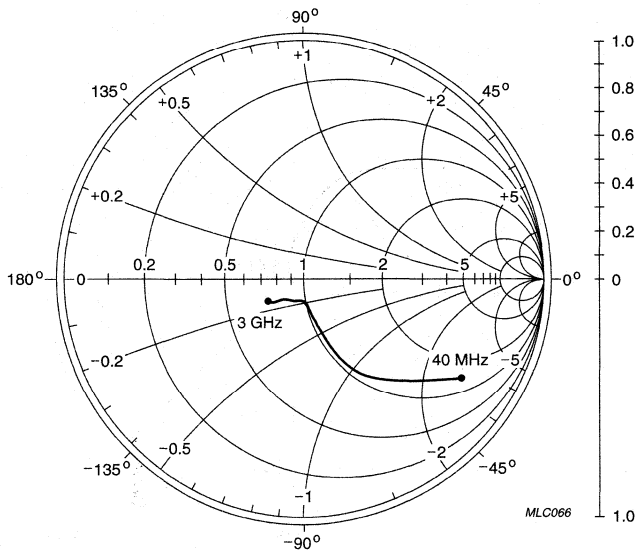
NPN 5 GHz wideband transistor

BFG590W
BFG590W/X; BFG590W/XR



$I_C = 80 \text{ mA}; V_{CE} = 4 \text{ V}.$

Fig.13 Common emitter reverse transmission coefficient (s_{12}); typical values.



$I_C = 80 \text{ mA}; V_{CE} = 4 \text{ V}; Z_o = 50 \Omega.$

Fig.14 Common emitter output reflection coefficient (s_{22}); typical values.

NPN 5 GHz wideband transistor

BFG590W
BFG590W/X; BFG590W/XR

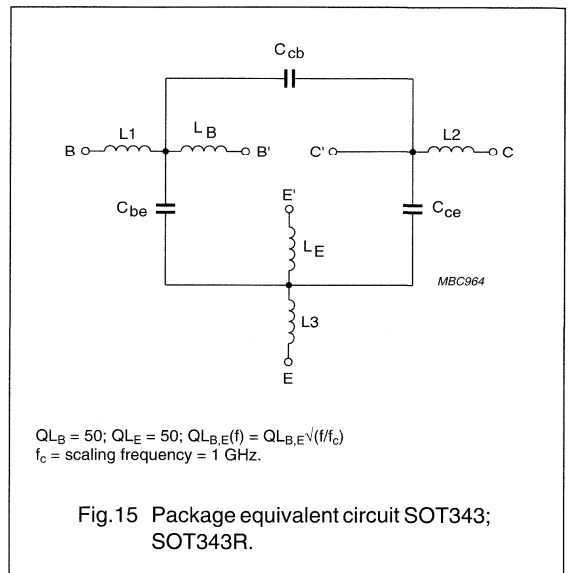
SPICE parameters for the BFG590W crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------------|
| 1 | IS | 1.341 | fA |
| 2 | BF | 123.5 | – |
| 3 | NF | 0.988 | – |
| 4 | VAF | 75.85 | V |
| 5 | IKF | 9.656 | A |
| 6 | ISE | 232.2 | fA |
| 7 | NE | 2.134 | – |
| 8 | BR | 10.22 | – |
| 9 | NR | 1.016 | – |
| 10 | VAR | 1.992 | V |
| 11 | IKR | 294.1 | mA |
| 12 | ISC | 211.0 | aA |
| 13 | NC | 0.997 | – |
| 14 | RB | 5.000 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 5.000 | Ω |
| 17 | RE | 1.275 | Ω |
| 18 | RC | 920.6 | m Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 3.821 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.348 | – |
| 25 | TF | 13.60 | ps |
| 26 | XTF | 71.73 | – |
| 27 | VTF | 10.28 | V |
| 28 | ITF | 1.929 | A |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 1.409 | pF |
| 31 | VJC | 219.4 | mV |
| 32 | MJC | 0.166 | – |
| 33 | XCJC | 0.150 | – |
| 34 | TR | 2.340 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.733 | – |

Note

1. These parameters have not been extracted, the default values are shown.

**List of components** (see Fig. 15).

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 70 | fF |
| C_{cb} | 50 | fF |
| C_{ce} | 115 | fF |
| L1 | 0.34 | nH |
| L2 | 0.10 | nH |
| L3 | 0.25 | nH |
| L_B | 0.40 | nH |
| L_E | 0.40 | nH |

NPN 7 GHz wideband transistor

BFG591

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

APPLICATIONS

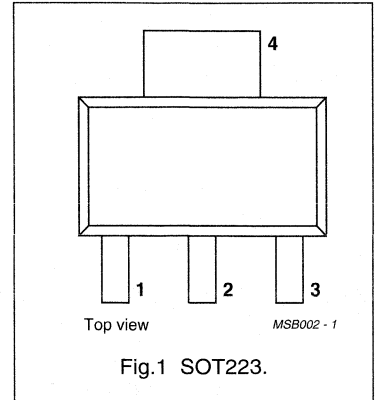
Intended for applications in the GHz range such as MATV or CATV amplifiers and RF communications subscriber equipment.

DESCRIPTION

NPN silicon planar epitaxial transistor in a plastic, 4-pin SOT223 package.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | emitter |
| 4 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | collector current (DC) | | – | – | 200 | mA |
| P_{tot} | total power dissipation | up to $T_s = 80\text{ °C}$; note 1 | – | – | 2 | W |
| h_{FE} | DC current gain | $I_C = 70\text{ mA}$; $V_{CE} = 8\text{ V}$ | 60 | 90 | 250 | |
| C_{re} | feedback capacitance | $I_C = I_c = 0$; $V_{CE} = 12\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| f_T | transition frequency | $I_C = 70\text{ mA}$; $V_{CE} = 12\text{ V}$; $f = 1\text{ GHz}$ | – | 7 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 70\text{ mA}$; $V_{CE} = 12\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 70\text{ mA}$; $V_{CE} = 12\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 12 | – | dB |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 7 GHz wideband transistor

BFG591

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| I_C | collector current (DC) | | – | 200 | mA |
| P_{tot} | total power dissipation | up to $T_s = 80\text{ °C}$; note 1 | – | 2 | W |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 150 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | note 1 | 35 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.

NPN 7 GHz wideband transistor

BFG591

CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ (unless otherwise specified).

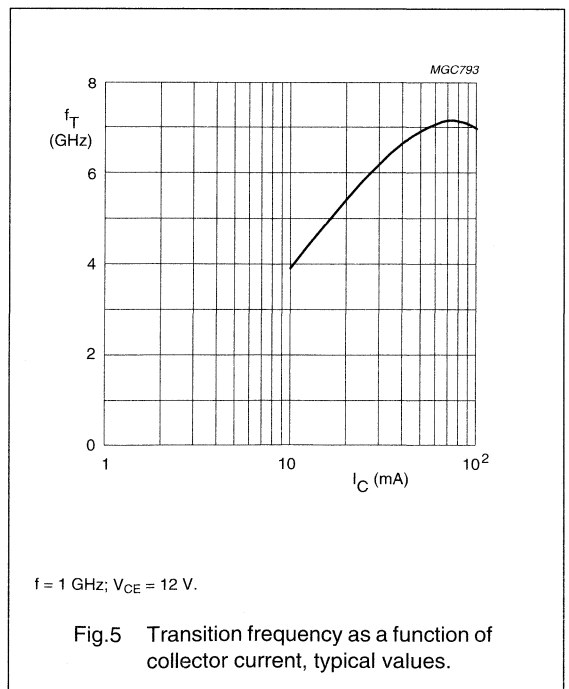
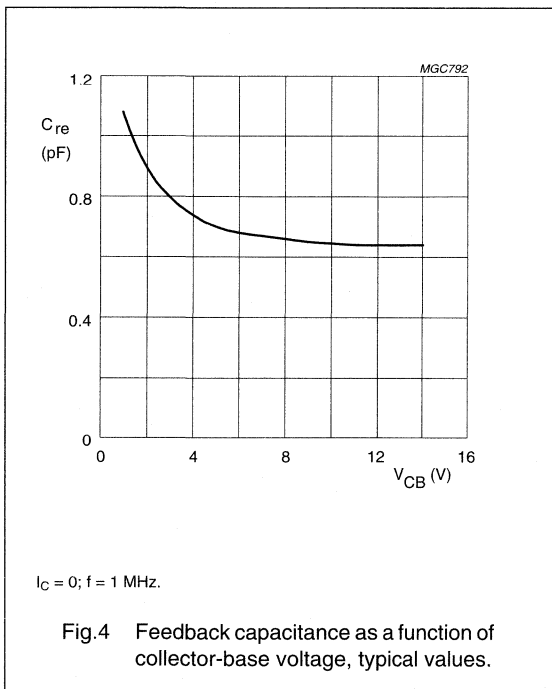
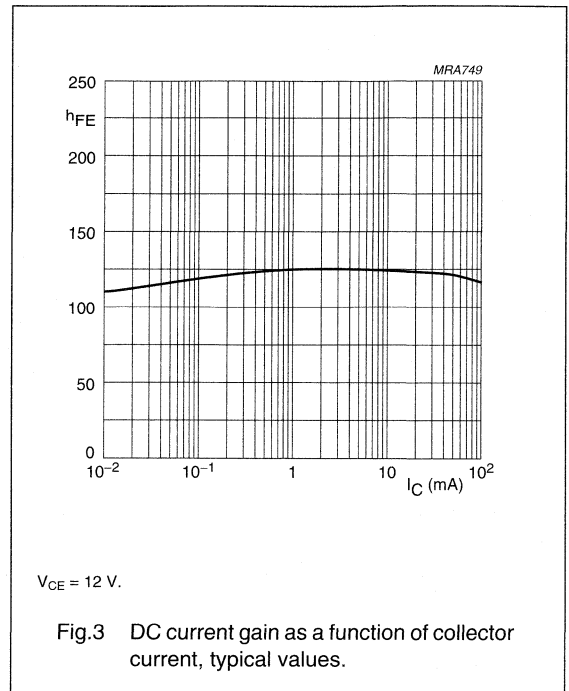
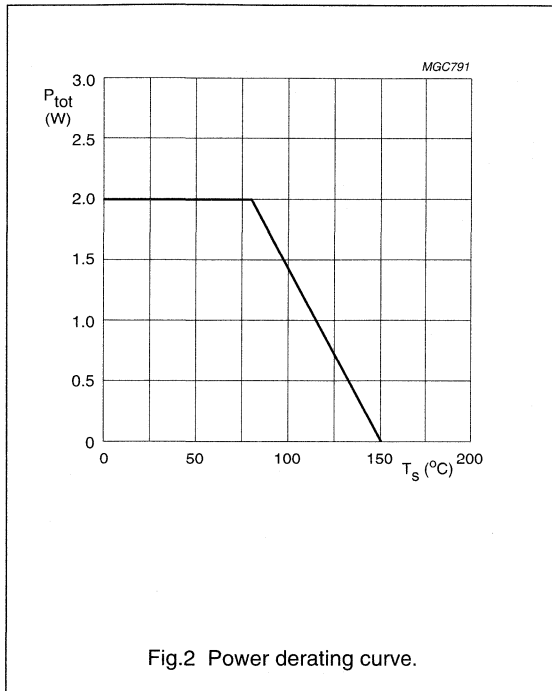
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|--|---|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 0.1\text{ mA}; I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CES}$ | collector-emitter breakdown voltage | $I_C = 10\text{ mA}; I_B = 0$ | 15 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 0.1\text{ mA}; I_C = 0$ | 3 | – | – | V |
| I_{CBO} | collector-base leakage current | $I_E = 0; V_{CB} = 10\text{ V}$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 70\text{ mA}; V_{CE} = 8\text{ V}$ | 60 | 90 | 250 | |
| C_{re} | feedback capacitance | $I_B = I_b = 0; V_{CE} = 12\text{ V};$ $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| f_T | transition frequency | $I_C = 70\text{ mA}; V_{CE} = 12\text{ V};$ $f = 1\text{ GHz}$ | – | 7 | – | GHz |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 70\text{ mA}; V_{CE} = 12\text{ V};$ $f = 900\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 13 | – | dB |
| | | $I_C = 70\text{ mA}; V_{CE} = 12\text{ V};$ $f = 2\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 7.5 | – | dB |
| $ s_{21} ^2$ | insertion power gain | $I_C = 70\text{ mA}; V_{CE} = 12\text{ V};$ $f = 1\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 12 | – | dB |
| V_o | output voltage | note 2 | – | 700 | – | mV |

Notes

- G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.
- $d_{im} = 60\text{ dB}$ (DIN45004B);
 $V_p = V_o$; $V_q = V_o - 6\text{ dB}$; $V_r = V_o - 6\text{ dB}$;
 $f_p = 795.25\text{ MHz}$; $f_q = 803.25\text{ MHz}$; $f_r = 803.25\text{ MHz}$; measured at $f_{(p+q-r)} = 793.25\text{ MHz}$.

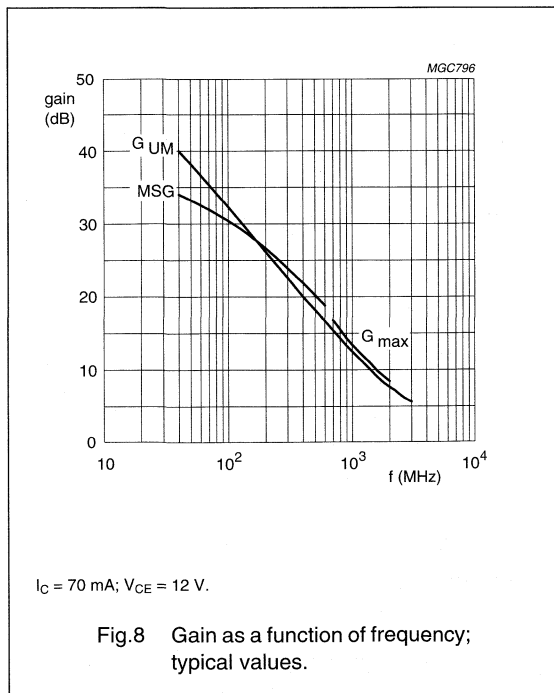
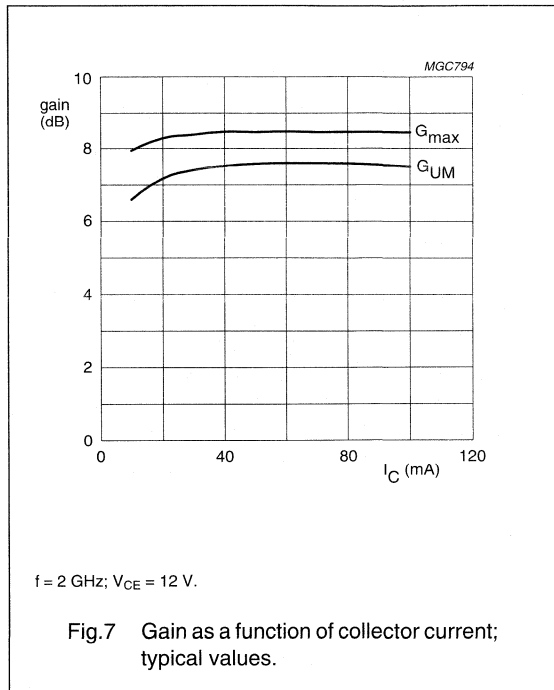
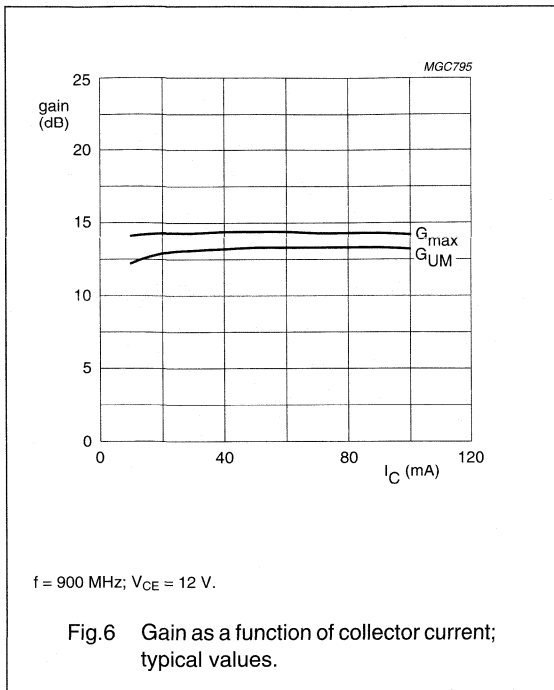
NPN 7 GHz wideband transistor

BFG591



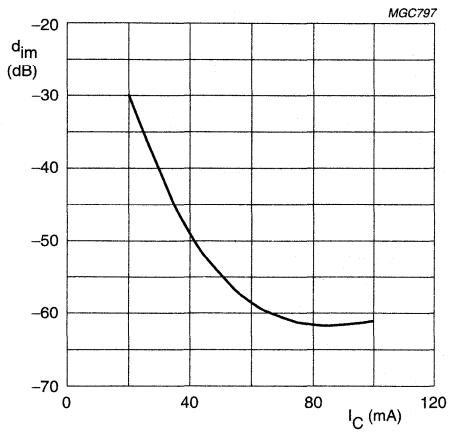
NPN 7 GHz wideband transistor

BFG591



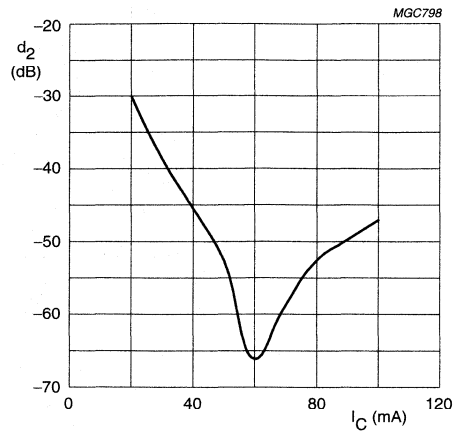
NPN 7 GHz wideband transistor

BFG591



$V_{CE} = 12$ V; $V_o = 700$ mV; $f_{(p+q-r)} = 793.25$ MHz.

Fig.9 Intermodulation distortion as a function of collector current; typical values.

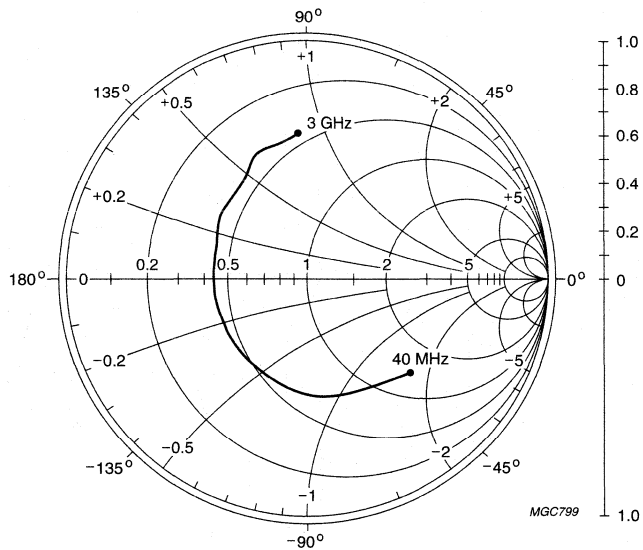


$V_{CE} = 12$ V; $V_o = 316$ mV; $f_{(p+q)} = 810$ MHz.

Fig.10 Second order Intermodulation distortion as a function of collector current; typical values.

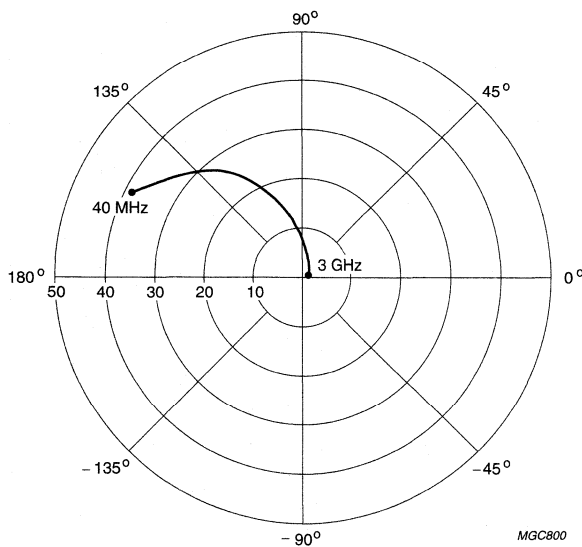
NPN 7 GHz wideband transistor

BFG591



$V_{CE} = 12\text{ V}; I_C = 70\text{ mA}; Z_0 = 50\ \Omega.$

Fig.11 Common emitter input reflection coefficient (s_{11}); typical values.

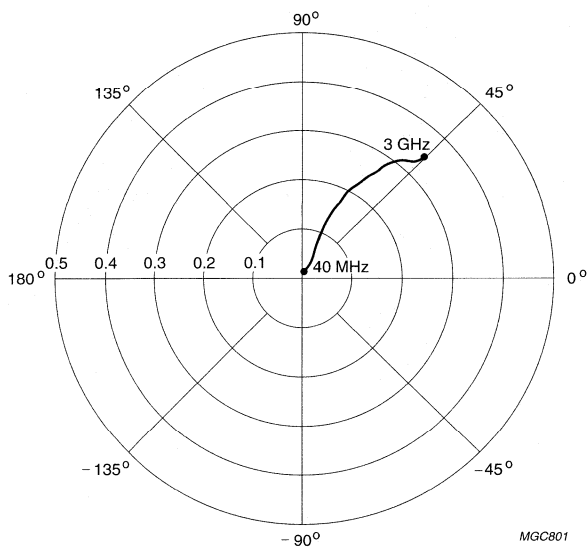


$V_{CE} = 12\text{ V}; I_C = 70\text{ mA}.$

Fig.12 Common emitter forward transmission coefficient (s_{21}); typical values.

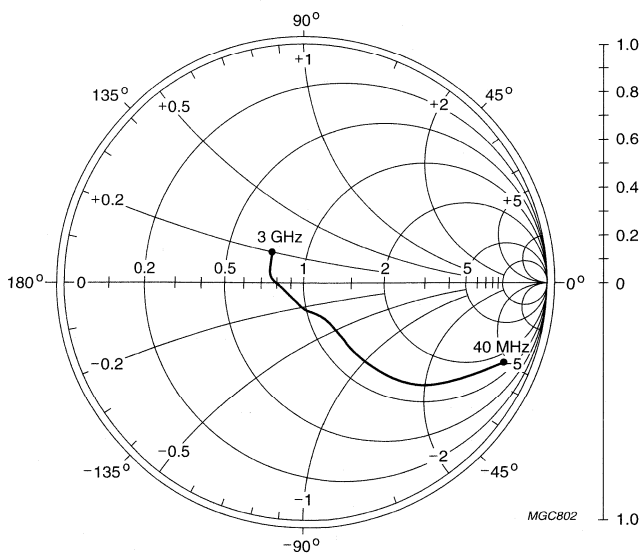
NPN 7 GHz wideband transistor

BFG591



$V_{CE} = 12\text{ V}; I_C = 70\text{ mA}$.

Fig.13 Common emitter reverse transmission coefficient (s_{12}); typical values.



$V_{CE} = 12\text{ V}; I_C = 70\text{ mA}; Z_0 = 50\ \Omega$.

Fig.14 Common emitter output reflection coefficient (s_{22}); typical values.

NPN 7 GHz wideband transistor

BFG591

SPICE parameters for the BFG591 crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|--------------|-----------|-------|------------|
| 1 | IS | 1.341 | fA |
| 2 | BF | 123.5 | – |
| 3 | NF | .988 | m |
| 4 | VAF | 75.85 | V |
| 5 | IKF | 9.656 | A |
| 6 | ISE | 232.2 | fA |
| 7 | NE | 2.134 | – |
| 8 | BR | 10.22 | – |
| 9 | NR | 1.016 | – |
| 10 | VAR | 1.992 | V |
| 11 | IKR | 294.1 | mA |
| 12 | ISC | 211.0 | aA |
| 13 | NC | 997.2 | – |
| 14 | RB | 5.00 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 5.00 | Ω |
| 17 | RE | 1.275 | Ω |
| 18 | RC | 920.6 | m Ω |
| 19 (1) | XTB | 0.000 | – |
| 20 (1) | EG | 1.110 | EV |
| 21 (1) | XTI | 3.000 | – |
| 22 | CJE | 3.821 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 348.5 | m |
| 25 | TF | 13.60 | ps |
| 26 | XTF | 71.73 | – |
| 27 | VTF | 10.28 | V |
| 28 | ITF | 1.929 | A |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 1.409 | pF |
| 31 | VJC | 219.4 | mV |
| 32 | MJC | 166.5 | m |
| 33 | XCJ | 2.340 | m |
| 34 | TR | 543.7 | ns |
| 35 (1) | CJS | 0.000 | F |
| 36 (1) | VJS | 750.0 | mV |
| 37 (1) | MJS | 0.000 | – |
| 38 | FC | 733.2 | m |

Note

- These parameters have not been extracted, the default values are shown.

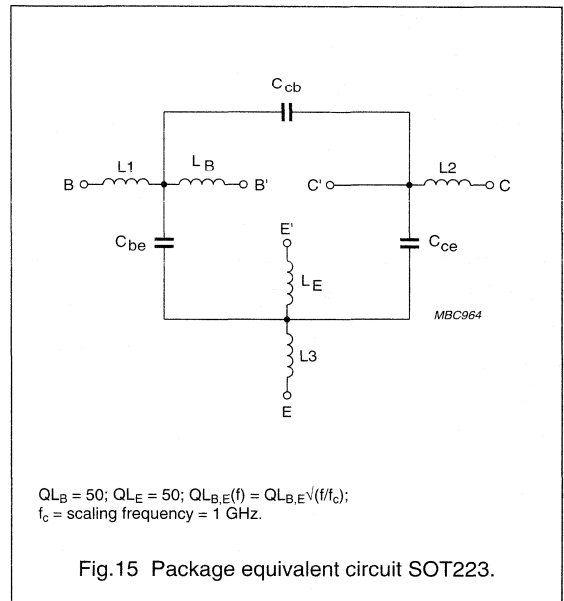


Fig. 15 Package equivalent circuit SOT223.

List of components (see Fig. 15)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 182 | fF |
| C_{cb} | 16 | fF |
| C_{ce} | 249 | fF |
| L1 | 0.025 | nH |
| L2 | 1.19 | nH |
| L3 | 0.60 | nH |
| L_B | 1.50 | nH |
| L_E | 0.50 | nH |

Dual NPN wideband transistor

BFM505

FEATURES

- Small size
- Temperature and h_{FE} matched
- Low noise and high gain
- High gain at low current and low capacitance at low voltage
- Gold metallization ensures excellent reliability.

APPLICATIONS

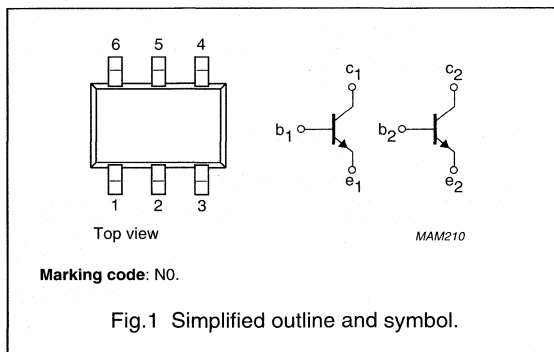
- Oscillator and buffer amplifiers
- Balanced amplifiers
- LNA/mixer.

DESCRIPTION

Dual transistor with two silicon NPN RF dies in a surface mount, 6-pin SOT363 (S-mini) package. The transistors are primarily intended for wideband applications in the GHz-range in the RF front end of analog and digital cellular phones, cordless phones, radar detectors, pagers and satellite TV-tuners.

PINNING - SOT363A

| PIN | SYMBOL | DESCRIPTION |
|-----|--------|-------------|
| 1 | b_1 | base 1 |
| 2 | e_1 | emitter 1 |
| 3 | c_2 | collector 2 |
| 4 | b_2 | base 2 |
| 5 | e_2 | emitter 2 |
| 6 | c_1 | collector 1 |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------------------|---|--|------|------|------|------|
| Any single transistor | | | | | | |
| C_{re} | feedback capacitance | $I_e = 0; V_{CB} = 3 \text{ V}; f = 1 \text{ MHz}$ | — | 0.22 | — | pF |
| f_T | transition frequency | $I_C = 5 \text{ mA}; V_{CE} = 3 \text{ V}; f = 1 \text{ GHz}$ | — | 9 | — | GHz |
| $ S_{21} ^2$ | insertion power gain | $I_C = 5 \text{ mA}; V_{CE} = 3 \text{ V}; f = 900 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$ | 14 | 15 | — | dB |
| G_{UM} | maximum unilateral power gain | $I_C = 5 \text{ mA}; V_{CE} = 3 \text{ V}; f = 900 \text{ MHz}; T_{amb} = 25 \text{ }^\circ\text{C}$ | — | 17 | — | dB |
| F | noise figure | $I_C = 1 \text{ mA}; V_{CE} = 3 \text{ V}; f = 900 \text{ MHz}; \Gamma_S = \Gamma_{opt}$ | — | 1.1 | 1.6 | dB |
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | single loaded | — | — | 230 | K/W |
| | | double loaded | — | — | 115 | K/W |

Dual NPN wideband transistor

BFM505

LIMITING VALUES

In accordance with the Absolute Maximum System IEC 134.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------------------|---------------------------|--------------------------------------|------|------|------|
| Any single transistor | | | | | |
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ °C}$; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | +175 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point; note 1 | single loaded | 230 | K/W |
| | | double loaded | 115 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.

Dual NPN wideband transistor

BFM505

CHARACTERISTICS

 $T_j = 25\text{ °C}$ unless otherwise specified.

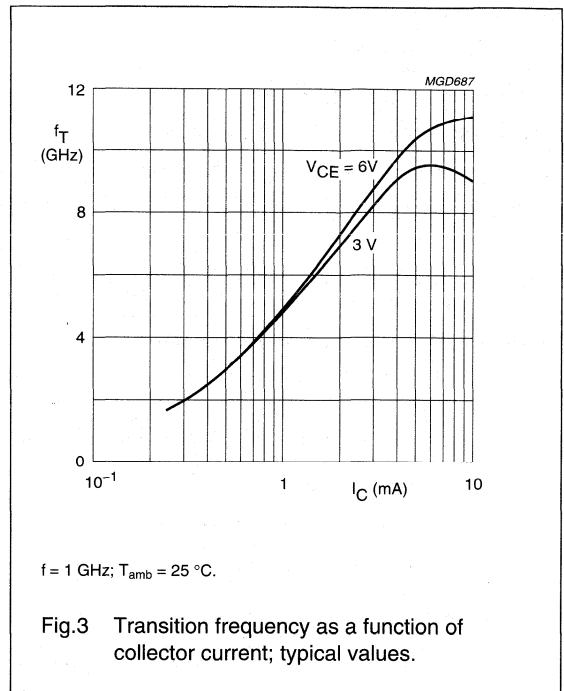
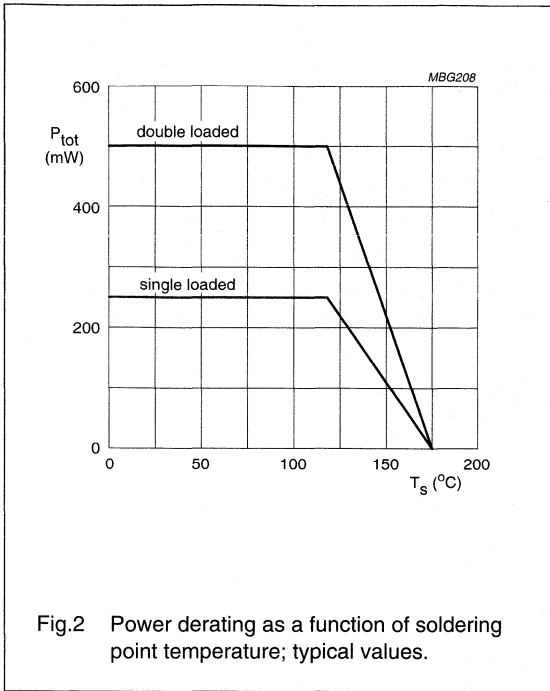
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--|---|--|------|------|------|------|
| DC characteristics of any single transistor | | | | | | |
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\ \mu\text{A}; I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 10\ \mu\text{A}; I_B = 0$ | 8 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 2.5\ \mu\text{A}; I_C = 0$ | 2.5 | – | – | V |
| I_{CBO} | collector-base leakage current | $V_{CB} = 6\ \text{V}; I_E = 0$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 5\ \text{mA}; V_{CE} = 6\ \text{V}$ | 60 | 120 | 250 | |
| DC characteristics of the dual transistor | | | | | | |
| Δh_{FE} | ratio of highest and lowest DC current gain | $I_{C1} = I_{C2} = 5\ \text{mA};$ $V_{CE1} = V_{CE2} = 6\ \text{V}$ | 1 | 1.2 | – | |
| ΔV_{BE0} | difference between highest and lowest base-emitter voltage (offset voltage) | $I_{E1} = I_{E2} = 10\ \text{mA}; T_{\text{amb}} = 25\text{ °C}$ | 0 | 1 | – | mV |
| AC characteristics of any single transistor | | | | | | |
| f_T | transition frequency | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V}; f = 1\ \text{GHz}$ | – | 9 | – | GHz |
| C_c | collector capacitance | $I_E = I_B = 0; V_{CB} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | 0.31 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | 0.22 | – | pF |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $T_{\text{amb}} = 25\text{ °C}; f = 900\ \text{MHz}$ | – | 17 | – | dB |
| | | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $T_{\text{amb}} = 25\text{ °C}; f = 2\ \text{GHz}$ | – | 10 | – | dB |
| $ s_{21} ^2$ | insertion power gain | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 900\ \text{MHz}; T_{\text{amb}} = 25\text{ °C}$ | 14 | 15 | – | dB |
| F | noise figure | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 900\ \text{MHz}; \Gamma_S = \Gamma_{\text{opt}}$ | – | 1.4 | 1.8 | dB |
| | | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 2\ \text{GHz}; \Gamma_S = \Gamma_{\text{opt}}$ | – | 1.9 | – | dB |
| | | $I_C = 1\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 900\ \text{MHz}; \Gamma_S = \Gamma_{\text{opt}}$ | – | 1.1 | 1.6 | dB |

Note

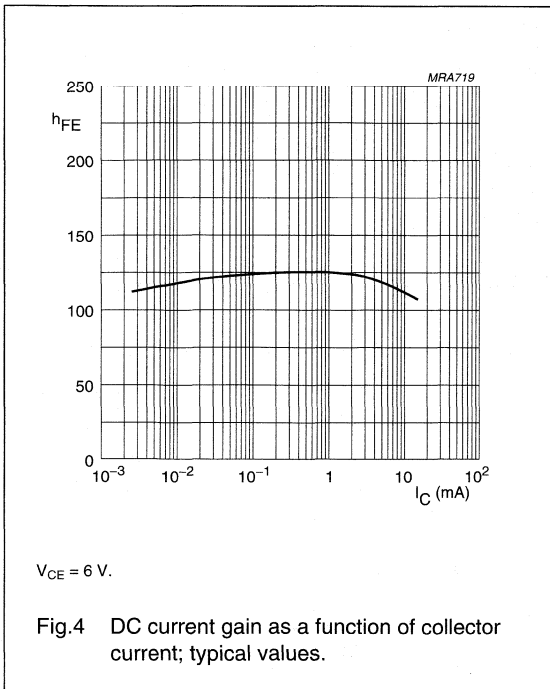
1. G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB

Dual NPN wideband transistor

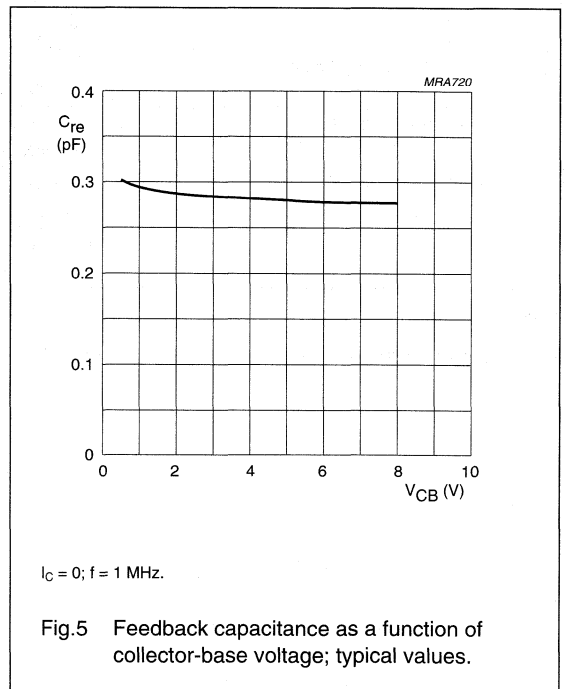
BFM505



$f = 1 \text{ GHz}; T_{\text{amb}} = 25 \text{ }^\circ\text{C}.$



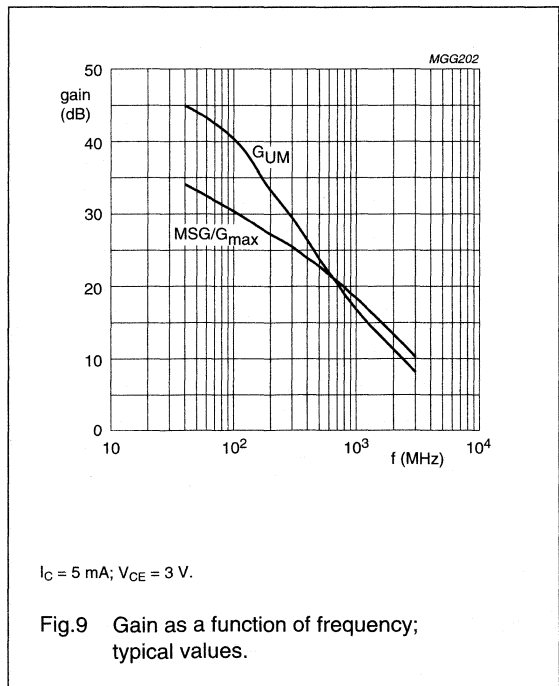
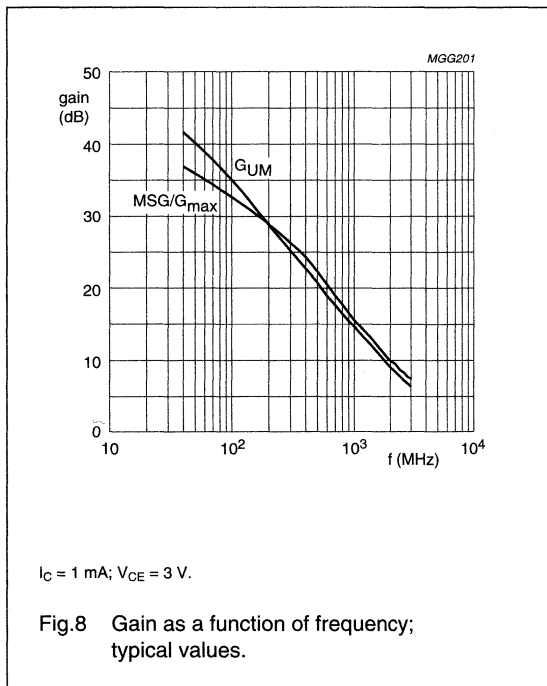
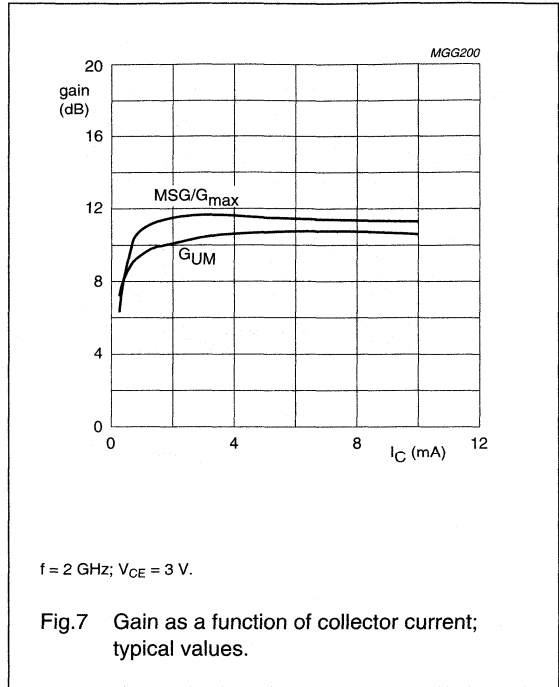
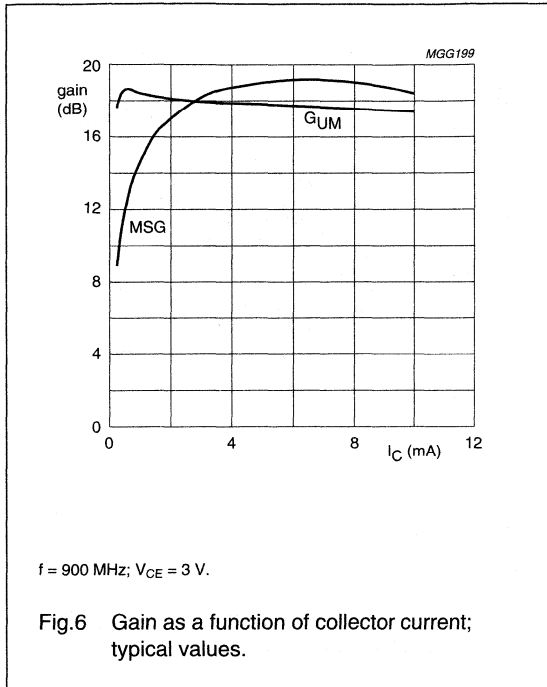
$V_{\text{CE}} = 6 \text{ V}.$



$I_C = 0; f = 1 \text{ MHz}.$

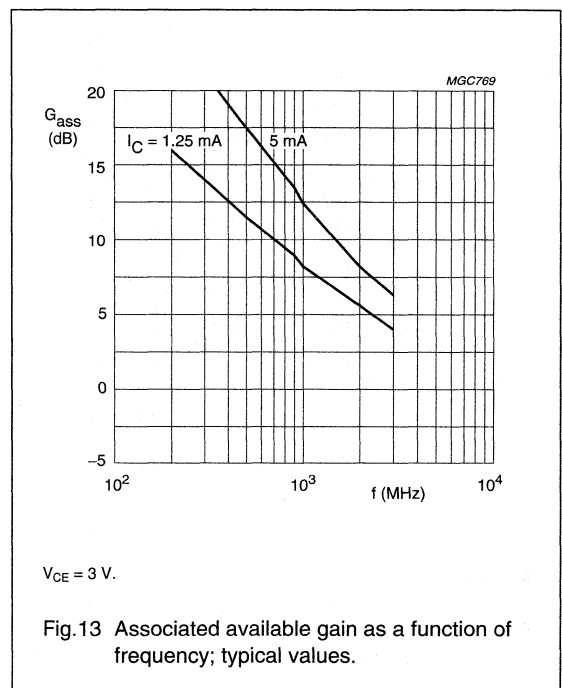
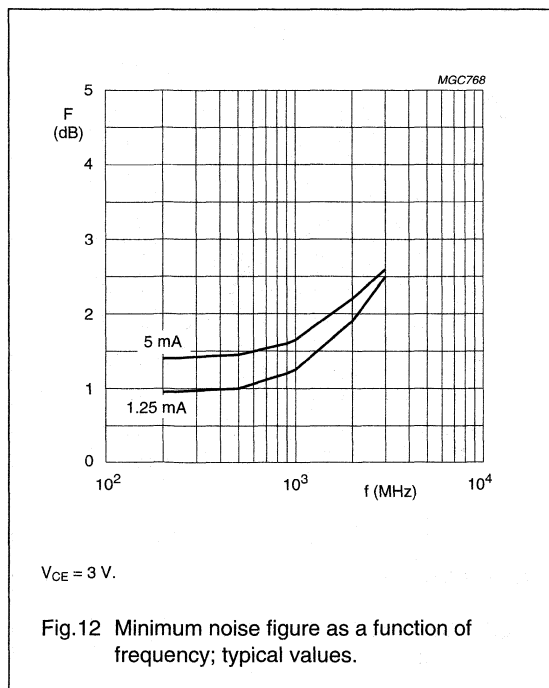
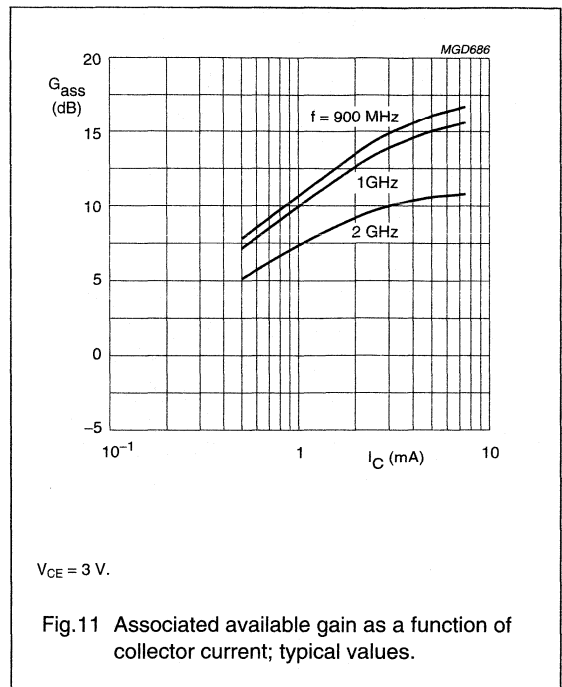
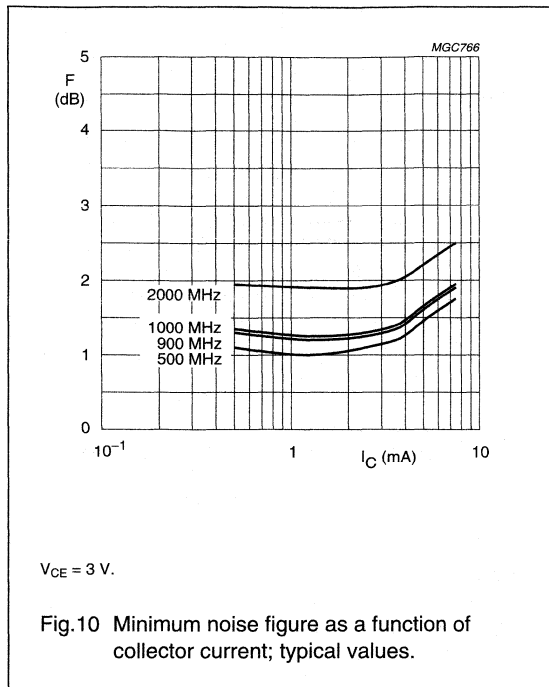
Dual NPN wideband transistor

BFM505



Dual NPN wideband transistor

BFM505



Dual NPN wideband transistor

BFM505

APPLICATION INFORMATION

SPICE parameters for any single BFM505 die

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 1 | IS | 134.1 | aA |
| 2 | BF | 180.0 | – |
| 3 | NF | 0.988 | – |
| 4 | VAF | 38.34 | V |
| 5 | IKF | 150.0 | mA |
| 6 | ISE | 27.81 | fA |
| 7 | NE | 2.051 | – |
| 8 | BR | 55.19 | – |
| 9 | NR | 0.982 | – |
| 10 | VAR | 2.459 | V |
| 11 | IKR | 2.920 | mA |
| 12 | ISC | 17.45 | aA |
| 13 | NC | 1.062 | – |
| 14 | RB | 20.00 | Ω |
| 15 | IRB | 1.000 | μA |
| 16 | RBM | 20.00 | Ω |
| 17 | RE | 1.171 | Ω |
| 18 | RC | 4.350 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 284.7 | fF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.303 | – |
| 25 | TF | 7.037 | ps |
| 26 | XTF | 12.34 | – |
| 27 | VTF | 1.701 | V |
| 28 | ITF | 30.64 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 242.4 | fF |
| 31 | VJC | 188.6 | mV |
| 32 | MJC | 0.041 | – |
| 33 | XCJC | 0.130 | – |
| 34 | TR | 1.332 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.897 | – |

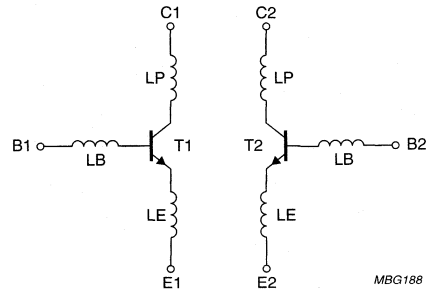


Fig.14 Package equivalent circuit SOT363A (inductance only).

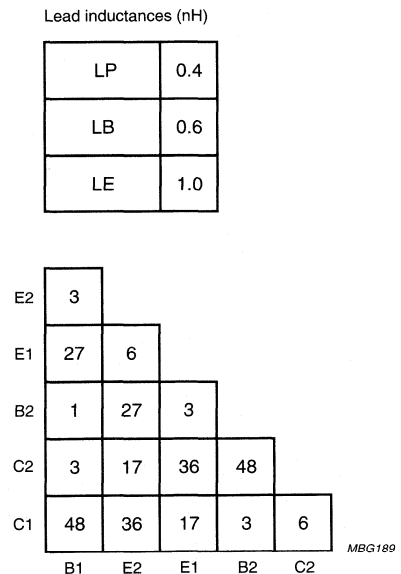


Fig.15 Package capacitance (fF) between indicated nodes.

Note

1. These parameters have not been extracted, the default values are shown.

Dual NPN wideband transistor

BFM520

FEATURES

- Small size
- Temperature and h_{FE} matched
- Low noise and high gain
- High gain at low current and low capacitance at low voltage
- Gold metallization ensures excellent reliability.

APPLICATIONS

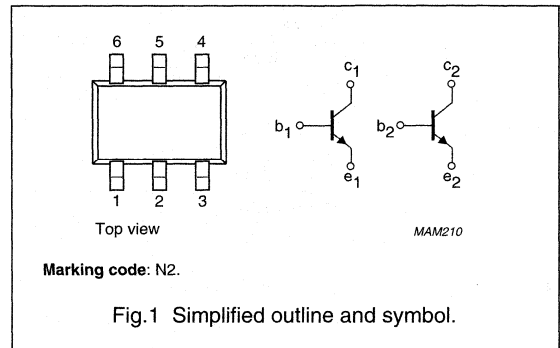
- Oscillator and buffer amplifiers
- Balanced amplifiers
- LNA/mixers.

DESCRIPTION

Dual transistor with two silicon NPN RF dies in a surface mount 6-pin SOT363 (S-mini) package. The transistor is primarily intended for wideband applications in the GHz-range in the RF front end of analog and digital cellular phones, cordless phones, radar detectors, pagers and satellite TV-tuners.

PINNING - SOT363A

| PIN | SYMBOL | DESCRIPTION |
|-----|--------|-------------|
| 1 | b_1 | base 1 |
| 2 | e_1 | emitter 1 |
| 3 | c_2 | collector 2 |
| 4 | b_2 | base 2 |
| 5 | e_2 | emitter 2 |
| 6 | c_1 | collector 1 |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------------------|---|---|------|------|------|------|
| Any single transistor | | | | | | |
| C_{re} | feedback capacitance | $I_e = 0$; $V_{CB} = 3$ V; $f = 1$ MHz | – | 0.4 | – | pF |
| f_T | transition frequency | $I_C = 20$ mA; $V_{CE} = 3$ V; $f = 900$ MHz | – | 9 | – | GHz |
| $ S_{21} ^2$ | insertion power gain | $I_C = 20$ mA; $V_{CE} = 3$ V; $f = 900$ MHz; $T_{amb} = 25$ °C | 13 | 14.5 | – | dB |
| G_{UM} | maximum unilateral power gain | $I_C = 20$ mA; $V_{CE} = 3$ V; $f = 900$ MHz; $T_{amb} = 25$ °C | – | 15 | – | dB |
| F | noise figure | $I_C = 5$ mA; $V_{CE} = 3$ V; $f = 900$ MHz; $\Gamma_S = \Gamma_{opt}$ | – | 1.2 | 1.6 | dB |
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | single loaded | – | – | 230 | K/W |
| | | double loaded | – | – | 115 | K/W |

Dual NPN wideband transistor

BFM520

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------------------|---------------------------|--------------------------------------|------|------|------|
| Any single transistor | | | | | |
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ °C}$; note 1 | – | 1 | W |
| T_{stg} | storage temperature | | –65 | +175 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point; note 1 | single loaded | 230 | K/W |
| | | double loaded | 115 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.

Dual NPN wideband transistor

BFM520

CHARACTERISTICS

 $T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--|---|---|------|------|------|------|
| DC characteristics of any single transistor | | | | | | |
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 2.5\ \mu\text{A}; I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 10\ \mu\text{A}; I_B = 0$ | 8 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 2.5\ \mu\text{A}; I_C = 0$ | 2.5 | – | – | V |
| I_{CBO} | collector-base leakage current | $V_{CB} = 6\ \text{V}; I_E = 0$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 20\ \text{mA}; V_{CE} = 6\ \text{V}$ | 60 | 120 | 250 | |
| DC characteristics of the dual transistor | | | | | | |
| Δh_{FE} | ratio of highest and lowest DC current gain | $I_{C1} = I_{C2} = 20\ \text{mA};$ $V_{CE1} = V_{CE2} = 6\ \text{V}$ | 1 | 1.2 | – | |
| ΔV_{BEO} | difference between highest and lowest base-emitter voltage (offset voltage) | $I_{E1} = I_{E2} = 30\ \text{mA}; T_{\text{amb}} = 25\text{ °C}$ | 0 | 1 | – | mV |
| AC characteristics of any single transistor | | | | | | |
| f_T | transition frequency | $I_C = 20\ \text{mA}; V_{CE} = 3\ \text{V}; f = 1\ \text{GHz}$ | – | 9 | – | GHz |
| C_C | collector capacitance | $I_E = i_e = 0; V_{CB} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | 0.5 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 3\ \text{V}; f = 1\ \text{MHz}$ | – | 0.4 | – | pF |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 20\ \text{mA}; V_{CE} = 3\ \text{V};$ $T_{\text{amb}} = 25\text{ °C}; f = 900\ \text{MHz}$ | – | 15 | – | dB |
| | | $I_C = 20\ \text{mA}; V_{CE} = 3\ \text{V};$ $T_{\text{amb}} = 25\text{ °C}; f = 2\ \text{GHz}$ | – | 9 | – | dB |
| $ s_{21} ^2$ | insertion power gain | $I_C = 20\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 900\ \text{MHz}; T_{\text{amb}} = 25\text{ °C}$ | 13 | 14.5 | – | dB |
| F | noise figure | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 900\ \text{MHz}; \Gamma_S = \Gamma_{\text{opt}}$ | – | 1.2 | 1.6 | dB |
| | | $I_C = 20\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 900\ \text{MHz}; \Gamma_S = \Gamma_{\text{opt}}$ | – | 1.7 | 2.1 | dB |
| | | $I_C = 5\ \text{mA}; V_{CE} = 3\ \text{V};$ $f = 2\ \text{GHz}; \Gamma_S = \Gamma_{\text{opt}}$ | – | 1.9 | – | dB |

Note

1. G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB

Dual NPN wideband transistor

BFM520

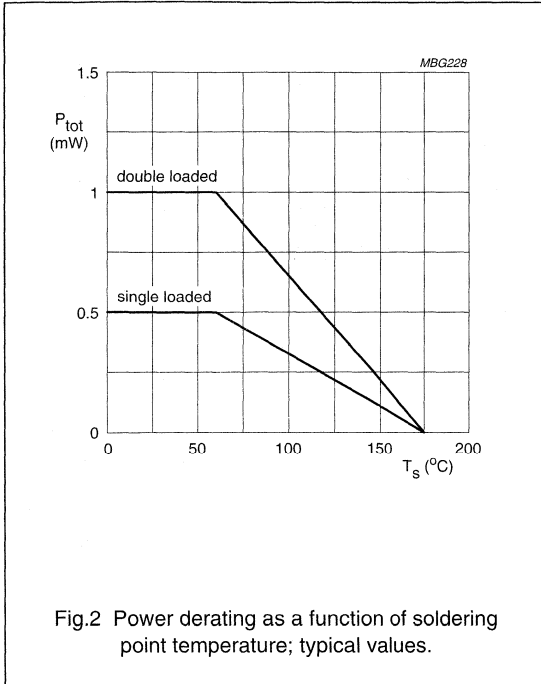
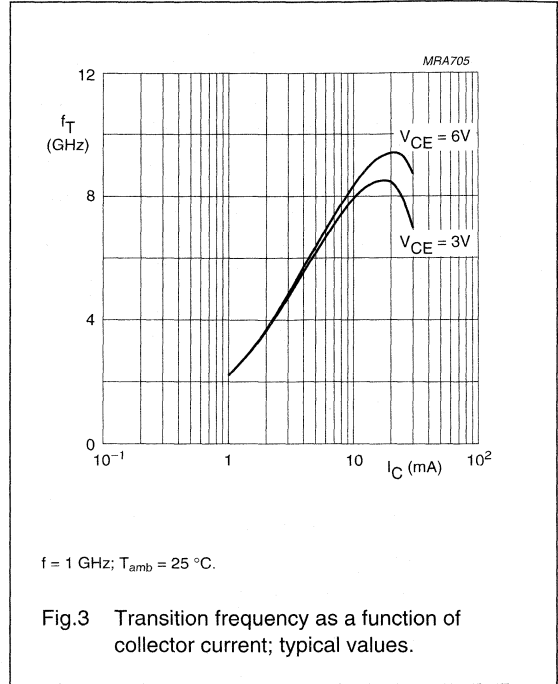
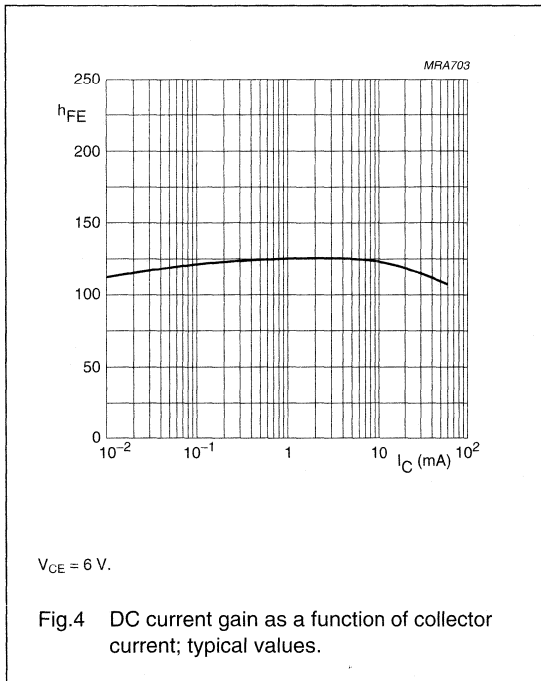


Fig.2 Power derating as a function of soldering point temperature; typical values.



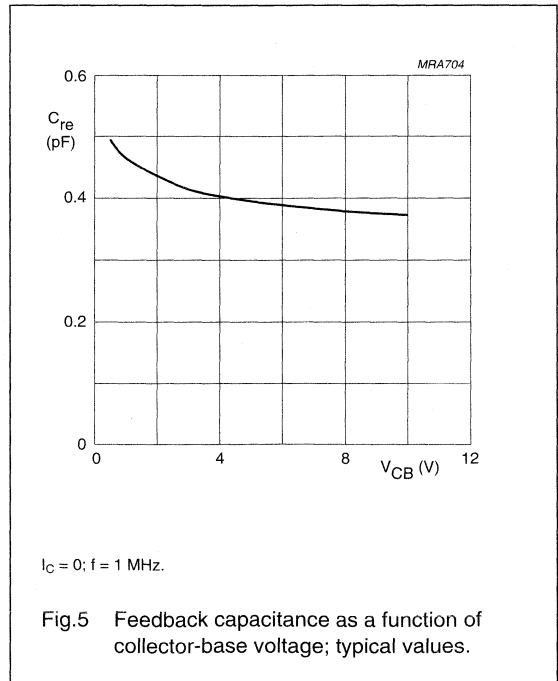
$f = 1$ GHz; $T_{amb} = 25$ $^{\circ}C$.

Fig.3 Transition frequency as a function of collector current; typical values.



$V_{CE} = 6$ V.

Fig.4 DC current gain as a function of collector current; typical values.

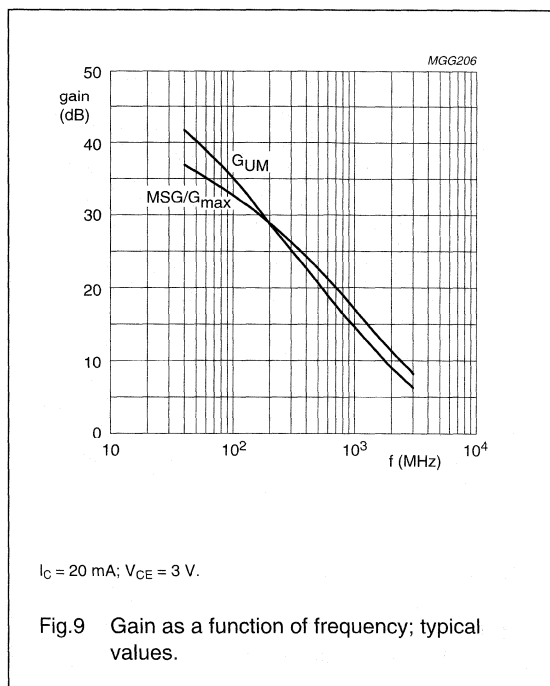
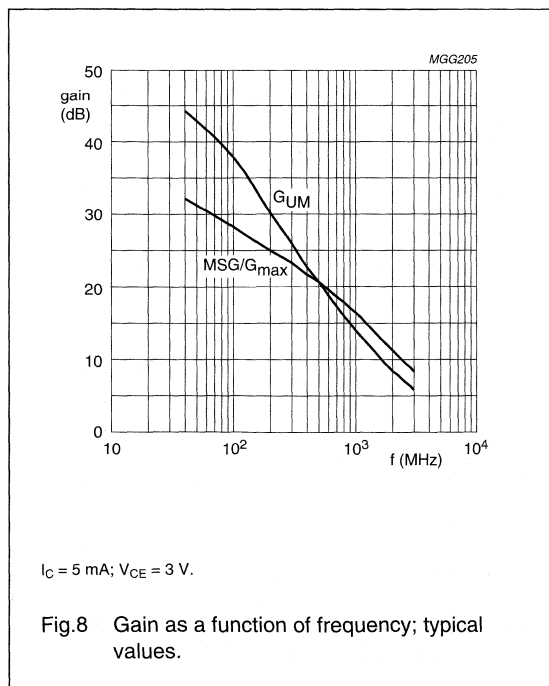
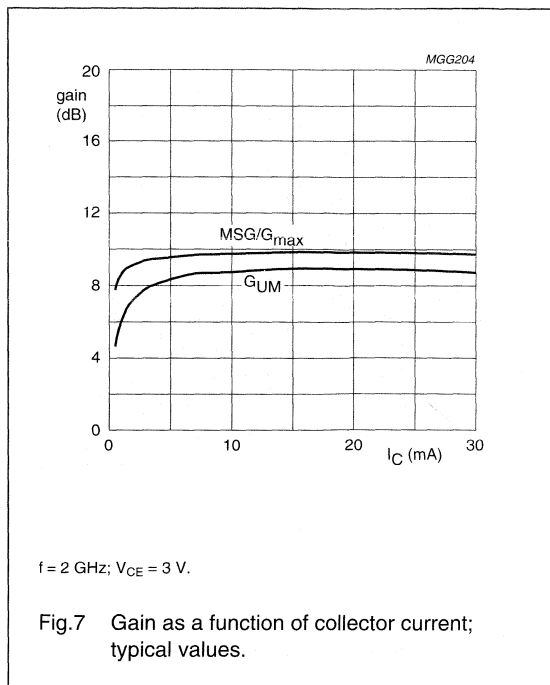
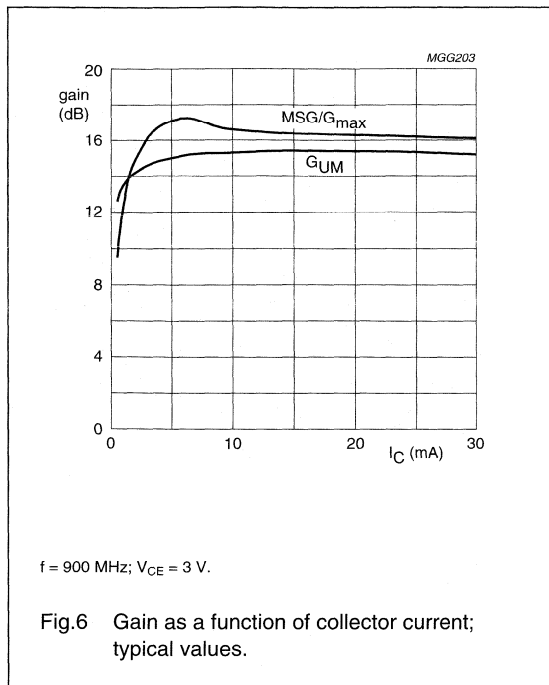


$I_C = 0$; $f = 1$ MHz.

Fig.5 Feedback capacitance as a function of collector-base voltage; typical values.

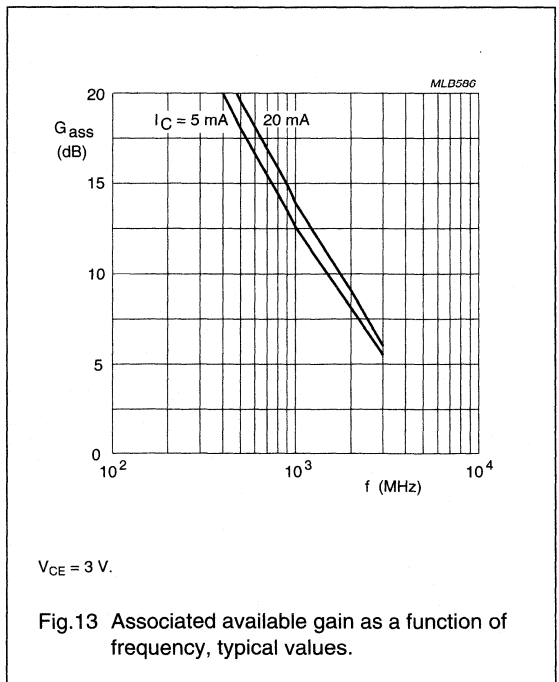
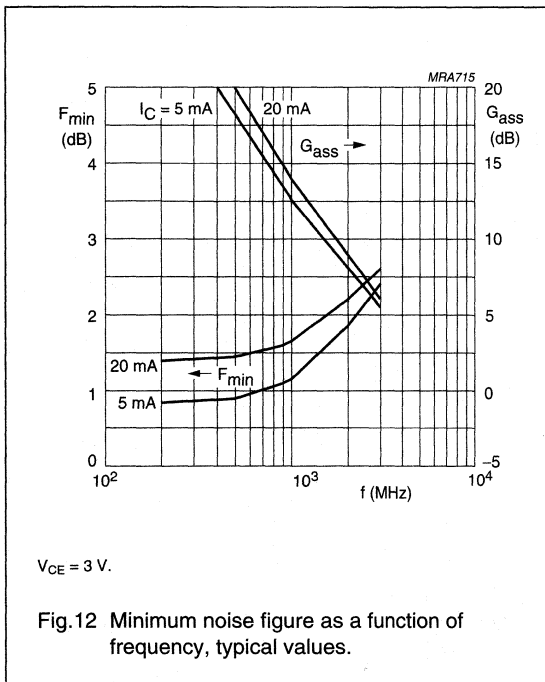
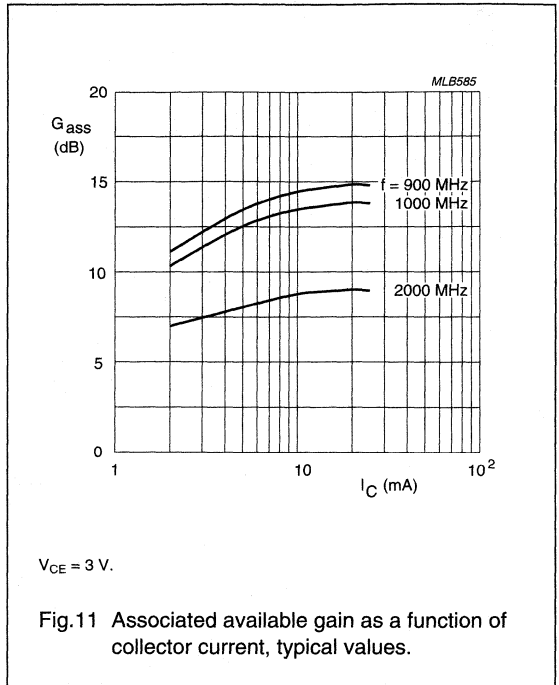
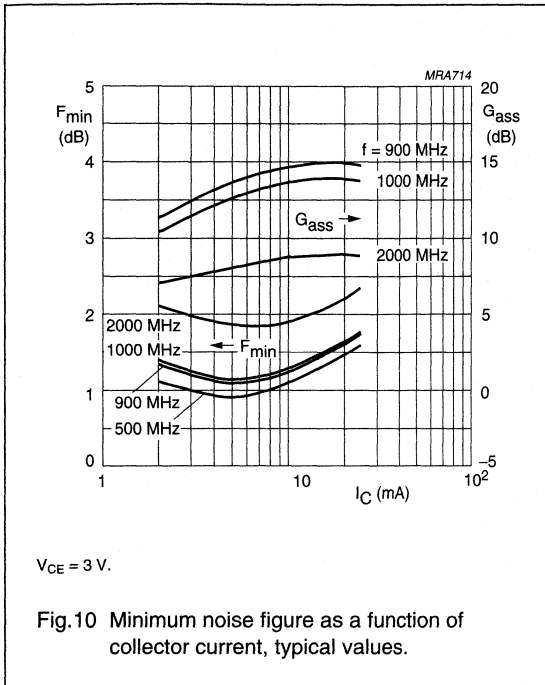
Dual NPN wideband transistor

BFM520



Dual NPN wideband transistor

BFM520



Dual NPN wideband transistor

BFM520

APPLICATION INFORMATION

SPICE parameters for any single BFM520 die

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|----------|
| 1 | IS | 1.016 | fA |
| 2 | BF | 220.1 | — |
| 3 | NF | 1.000 | — |
| 4 | VAF | 48.06 | V |
| 5 | IKF | 510.0 | mA |
| 6 | ISE | 283.0 | fA |
| 7 | NE | 2.035 | — |
| 8 | BR | 100.7 | — |
| 9 | NR | 0.988 | — |
| 10 | VAR | 1.692 | V |
| 11 | IKR | 2.352 | mA |
| 12 | ISC | 24.48 | aA |
| 13 | NC | 1.022 | — |
| 14 | RB | 10.00 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 10.00 | Ω |
| 17 | RE | 0.775 | Ω |
| 18 | RC | 2.210 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | — |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | — |
| 22 | CJE | 1.245 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.258 | — |
| 25 | TF | 8.616 | ps |
| 26 | XTF | 6.788 | — |
| 27 | VTF | 1.414 | V |
| 28 | ITF | 110.3 | mA |
| 29 | PTF | 45.01 | deg |
| 30 | CJC | 447.6 | fF |
| 31 | VJC | 189.2 | mV |
| 32 | MJC | 0.071 | — |
| 33 | XCJC | 0.130 | — |
| 34 | TR | 543.7 | ps |
| 35 ⁽¹⁾ | CJS | 0.000 | F |
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | — |
| 38 | FC | 0.780 | — |

Note

1. These parameters have not been extracted, the default values are shown.

Dual NPN wideband transistor

BFM520

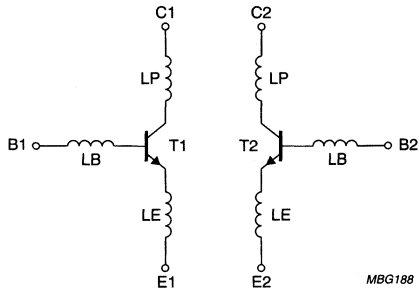


Fig.14 Package equivalent circuit SOT363A (inductance only).

Lead inductances (nH)

| | |
|----|-----|
| LP | 0.4 |
| LB | 0.6 |
| LE | 1.0 |

| | | | | | |
|----|----|----|----|----|----|
| E2 | 3 | | | | |
| E1 | 27 | 6 | | | |
| B2 | 1 | 27 | 3 | | |
| C2 | 3 | 17 | 36 | 48 | |
| C1 | 48 | 36 | 17 | 3 | 6 |
| | B1 | E2 | E1 | B2 | C2 |

MBG189

Fig.15 Package capacitance (fF) between indicated nodes.

NPN 1 GHz wideband transistor

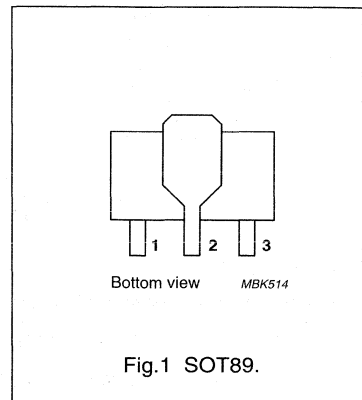
BFQ17

DESCRIPTION

NPN transistor in a SOT89 plastic envelope intended for application in thick and thin-film circuits. The transistor has extremely good intermodulation properties and a high power gain.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: FA | |
| 1 | emitter |
| 2 | collector |
| 3 | base |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 40 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| I_{CM} | peak collector current | | – | 300 | mA |
| P_{tot} | total power dissipation | up to $T_s = 145\text{ °C}$ (note 1) | – | 1 | W |
| f_T | transition frequency | $I_C = 150\text{ mA}$; $V_{CE} = 15\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ °C}$ | 1.5 | – | GHz |
| C_{re} | feedback capacitance | $I_C = 10\text{ mA}$; $V_{CE} = 15\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 1.9 | – | pF |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 40 | V |
| V_{CER} | collector-emitter voltage | $R_{BE} \leq 50\ \Omega$ | – | 40 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 150 | mA |
| I_{CM} | peak collector current | $f > 1\text{ MHz}$ | – | 300 | mA |
| P_{tot} | total power dissipation | up to $T_s = 145\text{ °C}$ (note 1) | – | 1 | W |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 1 GHz wideband transistor

BFQ17

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 145\text{ °C}$ (note 1) | 30 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|--|--|------|------|------|---------------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 20\text{ V}; T_j = 50\text{ °C}$ | – | – | 20 | μA |
| $V_{CE\ sat}$ | collector-emitter saturation voltage | $I_C = 100\text{ mA}; I_B = 10\text{ mA}$ | – | – | 0.5 | V |
| h_{FE} | DC current gain | $I_C = 150\text{ mA}; V_{CE} = 5\text{ V}$ | 25 | 80 | – | |
| C_c | collector capacitance | $I_E = I_e = 0; V_{CB} = 15\text{ V}; f = 1\text{ MHz}$ | – | – | 4 | pF |
| C_{re} | feedback capacitance | $I_C = 10\text{ mA}; V_{CE} = 15\text{ V}; f = 1\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 1.9 | – | pF |
| f_T | transition frequency | $I_C = 150\text{ mA}; V_{CE} = 15\text{ V}; f = 500\text{ MHz}$ | – | 1.5 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 60\text{ mA}; V_{CE} = 15\text{ V}; f = 200\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 16 | – | dB |
| | | $I_C = 60\text{ mA}; V_{CE} = 15\text{ V}; f = 800\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 6.5 | – | dB |

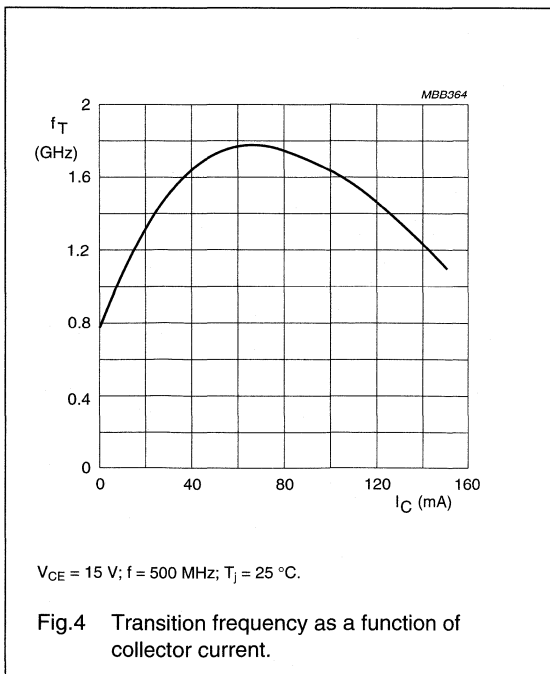
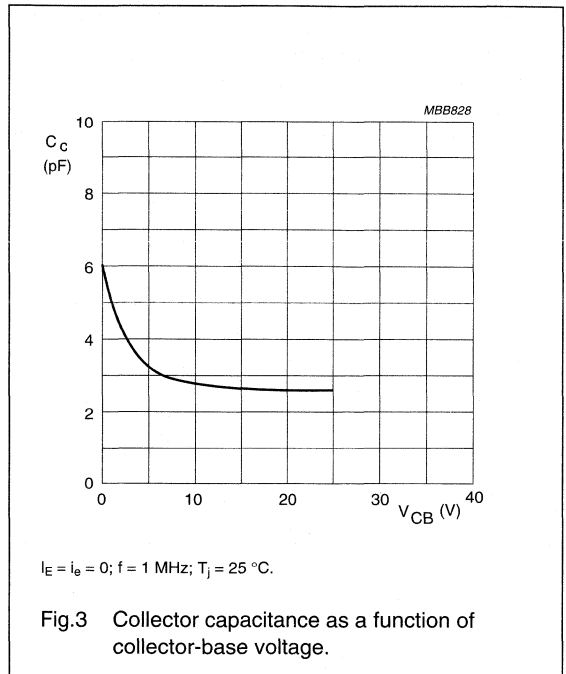
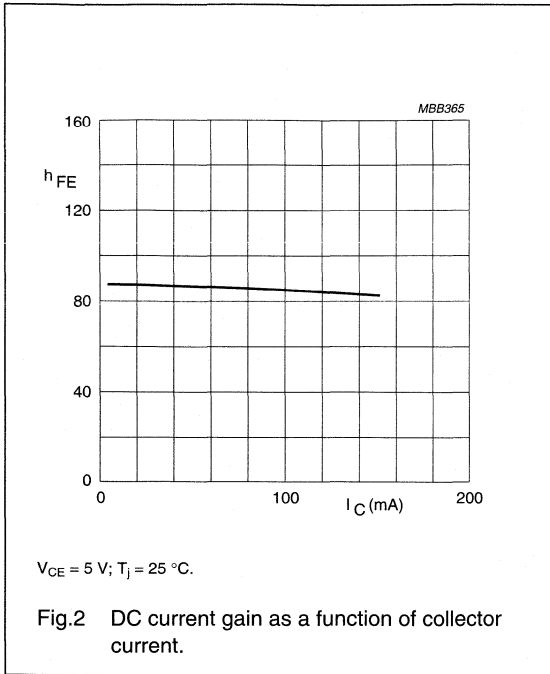
Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{dB.}$$

NPN 1 GHz wideband transistor

BFQ17



NPN 4 GHz wideband transistor

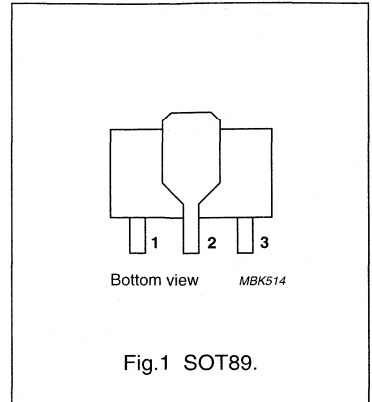
BFQ18A

DESCRIPTION

NPN transistor in a plastic SOT89 envelope intended for application in thick and thin-film circuits. It is primarily intended for MATV purposes.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: FF | |
| 1 | emitter |
| 2 | collector |
| 3 | base |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|----------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 18 | V |
| I_C | DC collector current | | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 155\text{ °C}$ (note 1) | – | 1 | W |
| f_T | transition frequency | $I_C = 100\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ °C}$ | 4 | – | GHz |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 10\text{ V}$; $f = 10.7\text{ MHz}$ | 1.2 | – | pF |
| d_{im} | intermodulation distortion | $I_C = 80\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\text{ }\Omega$; $V_o = 700\text{ mV}$; measured at $f_{(p+q-r)} = 793.25\text{ MHz}$ | – | –60 | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 18 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 155\text{ °C}$ (note 1) | – | 1 | W |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 4 GHz wideband transistor

BFQ18A

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 155\text{ °C}$ (note 1) | 20 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

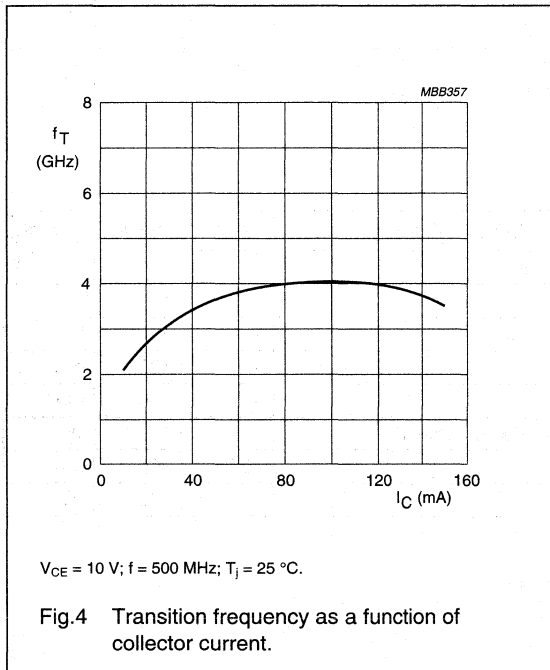
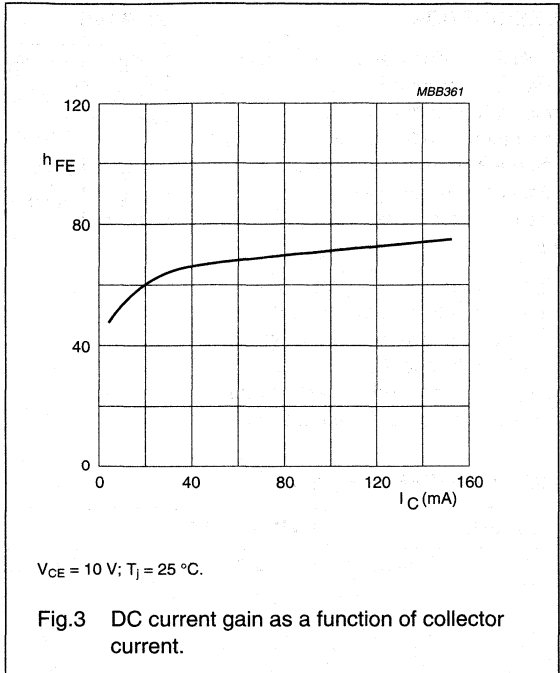
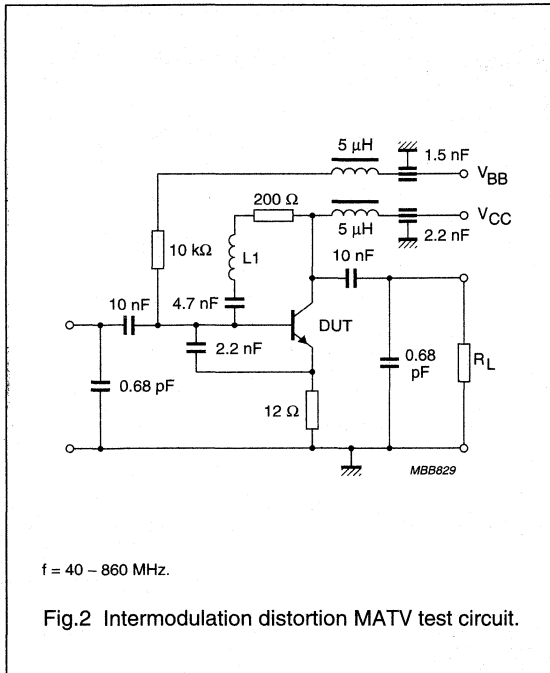
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | UNIT |
|----------|--|---|------|------|------|
| h_{FE} | DC current gain | $I_C = 100\text{ mA}; V_{CE} = 10\text{ V}$ | 25 | – | |
| C_c | collector capacitance | $I_E = I_e = 0; V_{CB} = 10\text{ V}; f = 1\text{ MHz}$ | – | 2 | pF |
| C_e | emitter capacitance | $I_C = I_c = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 11 | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = 10\text{ V}; f = 10.7\text{ MHz}$ | – | 1.2 | pF |
| f_T | transition frequency | $I_C = 100\text{ mA}; V_{CE} = 10\text{ V}; f = 500\text{ MHz}$ | – | 4 | GHz |
| d_{im} | intermodulation distortion (see Fig.2) | note 1 | – | –60 | dB |

Note

- $I_C = 80\text{ mA}; V_{CE} = 10\text{ V}; R_L = 75\ \Omega;$
 $V_p = V_o = 700\text{ mV}; f_p = 795.25\text{ MHz};$
 $V_q = V_o - 6\text{ dB}; f_q = 803.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_r = 805.25\text{ MHz};$
 measured at $f_{(p+q+r)} = 793.25\text{ MHz}.$

NPN 4 GHz wideband transistor

BFQ18A



NPN 5 GHz wideband transistor

BFQ19

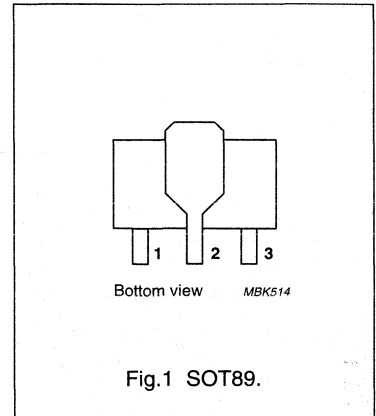
DESCRIPTION

NPN transistor in a SOT89 plastic envelope intended for application in thick and thin-film circuits. It is primarily intended for use in UHF and microwave amplifiers such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analyzers etc.

The transistor features very low intermodulation distortion and high power gain. Due to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: FB | |
| 1 | emitter |
| 2 | collector |
| 3 | base |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|---------------------------|---|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | — | 15 | V |
| I_C | DC collector current | | — | 100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 145\text{ °C}$ (note 1) | — | 1 | W |
| f_T | transition frequency | $I_C = 50\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ °C}$ | 5.5 | — | GHz |
| C_{re} | feedback capacitance | $I_C = 10\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 1.3 | — | pF |
| F | noise figure | $I_C = 50\text{ mA}$; $V_{CE} = 10\text{ V}$; $Z_s = \text{opt.}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 3.3 | — | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CB0} | collector-base voltage | open emitter | — | 20 | V |
| V_{CE0} | collector-emitter voltage | open base | — | 15 | V |
| V_{EB0} | emitter-base voltage | open collector | — | 3.3 | V |
| I_C | DC collector current | | — | 100 | mA |
| I_{CM} | peak collector current | $f > 1\text{ MHz}$ | — | 150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 145\text{ °C}$ (note 1) | — | 1 | W |
| T_{stg} | storage temperature | | -65 | 150 | °C |
| T_j | junction temperature | | — | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 5 GHz wideband transistor

BFQ19

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 145\text{ °C}$ (note 1) | 30 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 10\text{ V}$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 70\text{ mA}; V_{CE} = 10\text{ V}$ | 25 | 80 | – | |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 10\text{ V}; f = 1\text{ MHz}$ | – | 1.6 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 5 | – | pF |
| C_{re} | feedback capacitance | $I_C = 10\text{ mA}; V_{CE} = 10\text{ V}; f = 1\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 1.3 | – | pF |
| f_T | transition frequency | $I_C = 70\text{ mA}; V_{CE} = 10\text{ V}; f = 500\text{ MHz}$ | 4.4 | 5.5 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 50\text{ mA}; V_{CE} = 10\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 11.5 | – | dB |
| | | $I_C = 50\text{ mA}; V_{CE} = 10\text{ V}; f = 800\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 7.5 | – | dB |
| F | noise figure | $I_C = 50\text{ mA}; V_{CE} = 10\text{ V}; Z_s = \text{opt.}; f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 3.3 | – | dB |

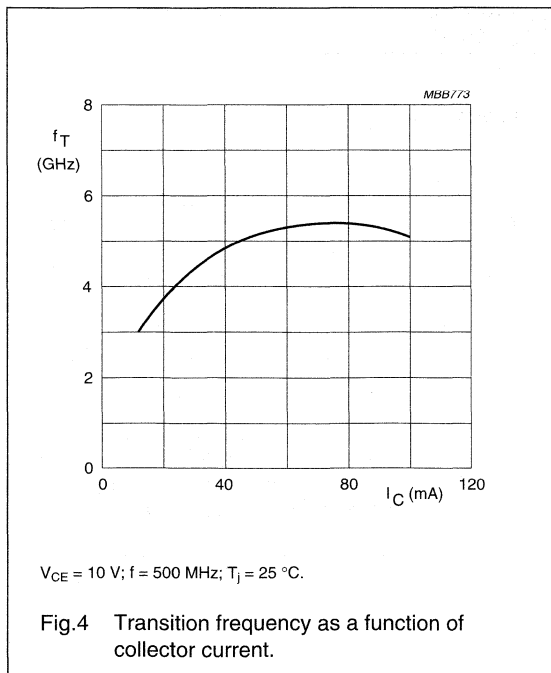
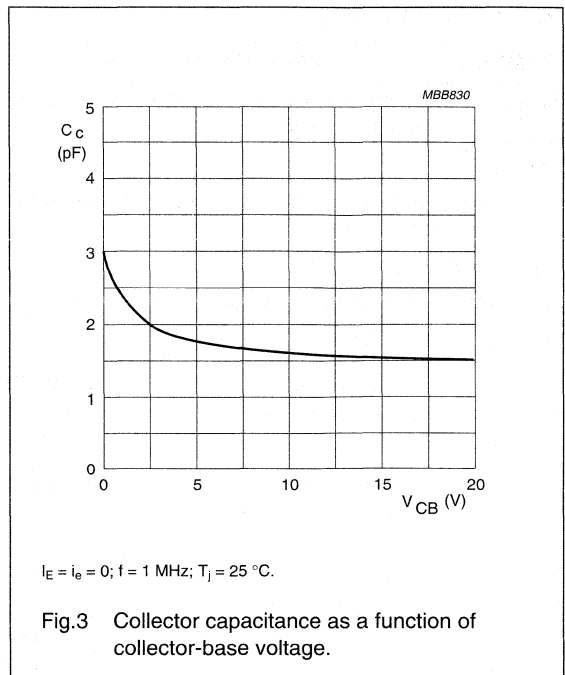
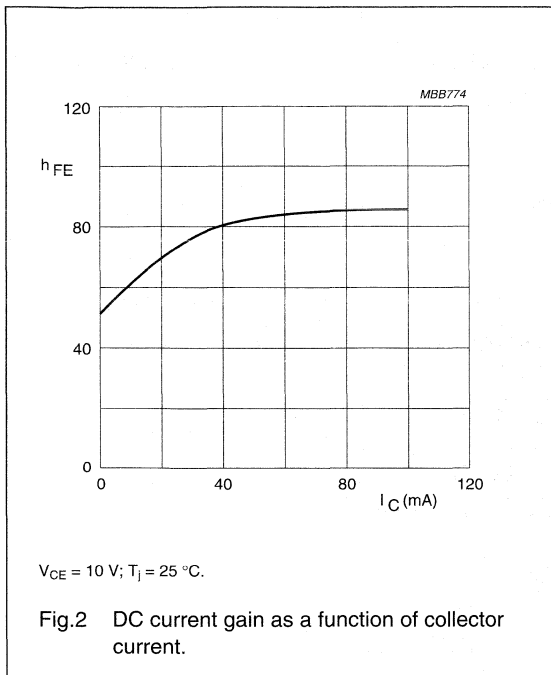
Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

NPN 5 GHz wideband transistor

BFQ19



NPN 4 GHz wideband transistor

BFQ34

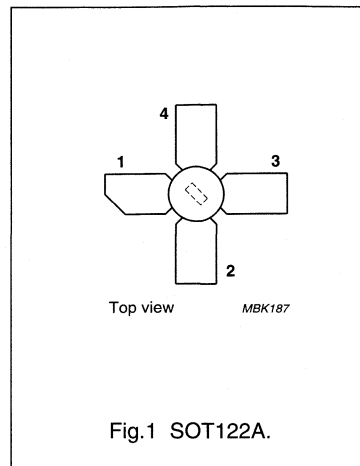
DESCRIPTION

NPN transistor encapsulated in a 4 lead SOT122A envelope with a ceramic cap. All leads are isolated from the stud.

It is primarily intended for driver and final stages in MATV system amplifiers. It is also suitable for use in low power band IV and V equipment. Diffused emitter-ballasting resistors and the application of gold sandwich metallization ensure an optimum temperature profile and excellent reliability properties. The device also features high output voltage capabilities.

PINNING

| PIN | DESCRIPTION |
|----------------|-------------|
| Code: BFQ34/01 | |
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|---------------------------------------|---|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 18 | V |
| I_C | collector current | | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_c = 160\text{ °C}$ | – | 2.7 | W |
| f_T | transition frequency | $I_C = 150\text{ mA}$; $V_{CE} = 15\text{ V}$; $f = 500\text{ MHz}$ | 4 | – | GHz |
| V_o | output voltage | $I_C = 120\text{ mA}$; $V_{CE} = 15\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$; $d_{im} = -60\text{ dB}$ $f_{(p+q-r)} = 793.25\text{ MHz}$ | 1.2 | – | V |
| P_{L1} | output power at 1 dB gain compression | $I_C = 120\text{ mA}$; $V_{CE} = 15\text{ V}$; $R_L = 75\ \Omega$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 26 | – | dBm |
| ITO | third order intercept point | $I_C = 120\text{ mA}$; $V_{CE} = 15\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$ | 45 | – | dBm |

WARNING

Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

NPN 4 GHz wideband transistor

BFQ34

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-----------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 18 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_c = 160\text{ °C}$ | – | 2.7 | W |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 200 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|--|--------------------|
| $R_{th\ j-c}$ | thermal resistance from junction to case | 15 K/W |

NPN 4 GHz wideband transistor

BFQ34

CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|---------------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 15\text{ V}$ | – | – | 100 | μA |
| h_{FE} | DC current gain | $I_C = 75\text{ mA}; V_{CE} = 15\text{ V}$ | 25 | 70 | – | |
| | | $I_C = 150\text{ mA}; V_{CE} = 15\text{ V}$ | 25 | 70 | – | |
| f_T | transition frequency | $I_C = 75\text{ mA}; V_{CE} = 15\text{ V}; f = 500\text{ MHz}$ | 3 | 3.5 | – | GHz |
| | | $I_C = 150\text{ mA}; V_{CE} = 15\text{ V}; f = 500\text{ MHz}$ | 3.5 | 4 | – | GHz |
| C_c | collector capacitance | $I_E = 0; V_{CB} = 15\text{ V}; f = 1\text{ MHz}$ | – | 2 | 2.75 | pF |
| C_e | emitter capacitance | $I_C = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 11 | – | pF |
| C_{re} | feedback capacitance | $I_C = 10\text{ mA}; V_{CE} = 15\text{ V}; f = 1\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1 | 1.35 | pF |
| C_{c-s} | collector-stud capacitance | note 1 | – | 0.8 | – | pF |
| F | noise figure (see Fig.2) | $I_C = 120\text{ mA}; V_{CE} = 15\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 8 | – | dB |
| G_{UM} | maximum unilateral power gain (note 2) | $I_C = 120\text{ mA}; V_{CE} = 15\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 16.3 | – | dB |
| V_o | output voltage | Figs 2 and 7 and note 3 | – | 1.2 | – | V |
| P_{L1} | output power at 1 dB gain compression (see Fig.2) | note 4 | – | 26 | – | dBm |
| ITO | third order intercept point (see Fig.2) | note 5 | – | 45 | – | dBm |

Notes

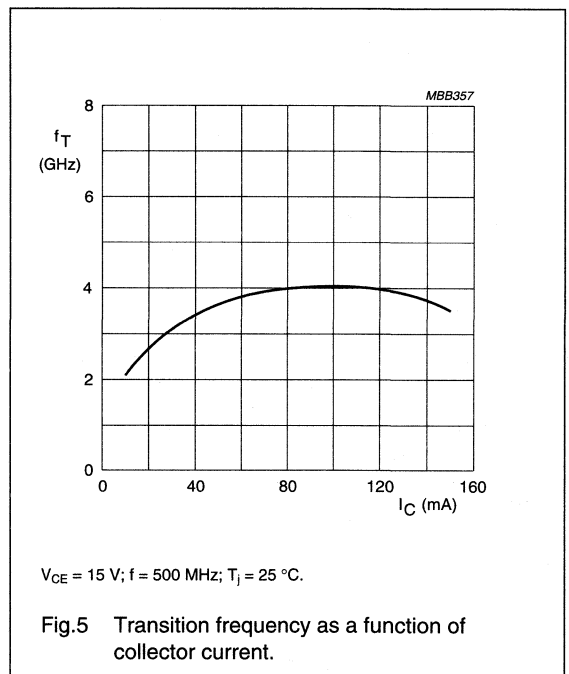
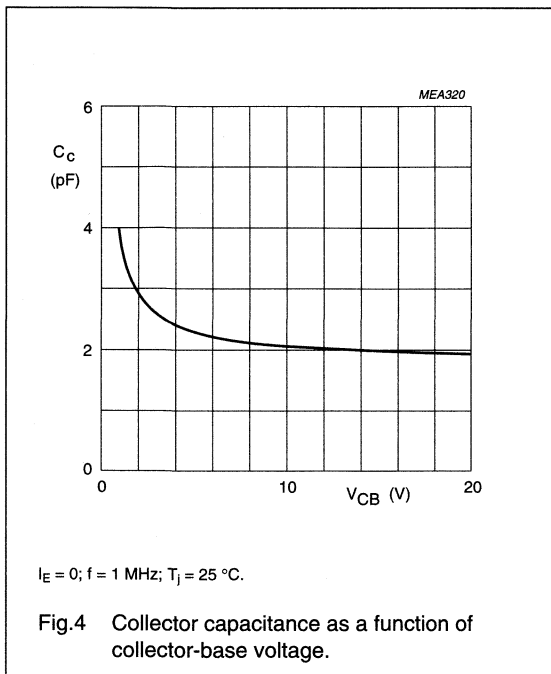
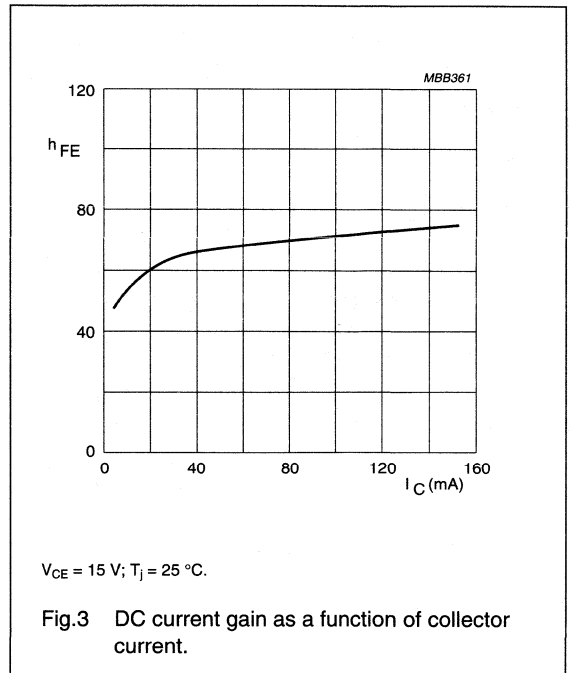
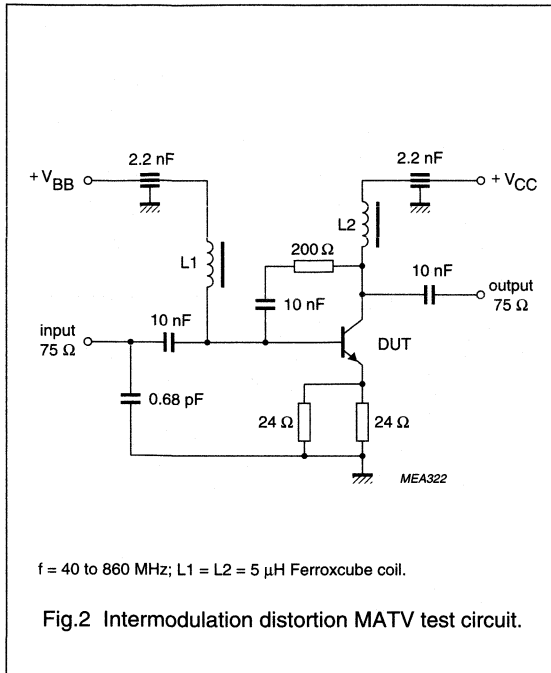
1. Measured with grounded emitter and base.
2. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{dB.}$$

3. $d_{im} = -60\text{ dB}$ (DIN 45004B, par. 6.3.: 3-tone); $I_C = 120\text{ mA}; V_{CE} = 15\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ }^\circ\text{C};$
 $V_p = V_o$ at $d_{im} = -60\text{ dB}; f_p = 795.25\text{ MHz};$
 $V_q = V_o - 6\text{ dB}; f_q = 803.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_r = 805.25\text{ MHz};$
measured at $f_{(p+q-r)} = 793.25\text{ MHz}.$
4. $I_C = 120\text{ mA}; V_{CE} = 15\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; R_L = 75\text{ }\Omega;$
measured at $f = 800\text{ MHz}.$
5. $I_C = 120\text{ mA}; V_{CE} = 15\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ }^\circ\text{C};$
 $P_p = \text{ITO} - 6\text{ dB}; f_p = 800\text{ MHz};$
 $P_q = \text{ITO} - 6\text{ dB}; f_q = 801\text{ MHz};$
measured at $f_{(2q-p)} = 802\text{ MHz}$ and at $f_{(2p-q)} = 799\text{ MHz}.$

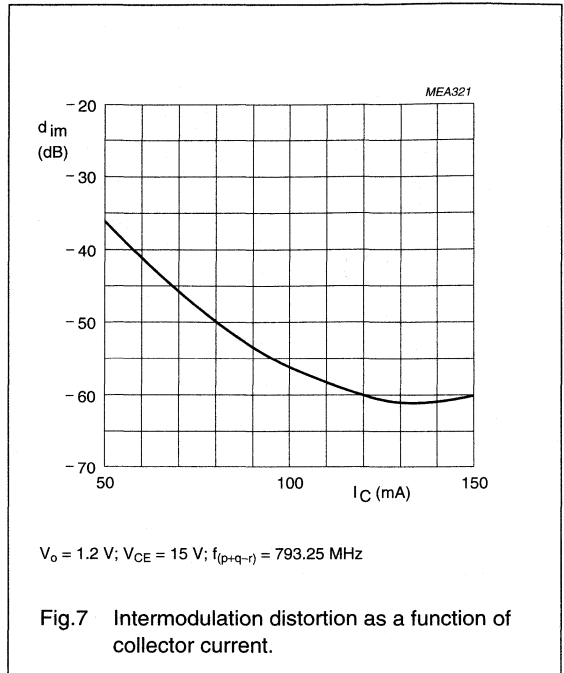
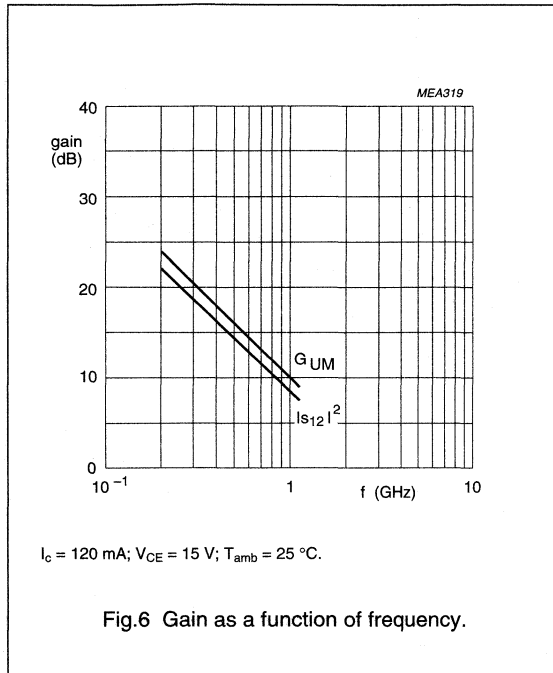
NPN 4 GHz wideband transistor

BFQ34



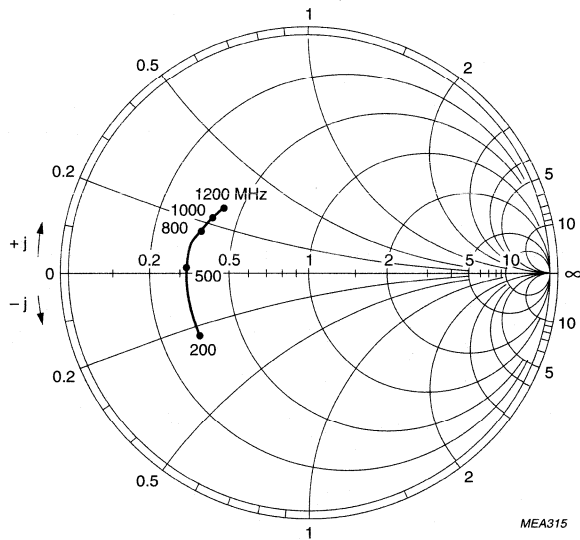
NPN 4 GHz wideband transistor

BFQ34



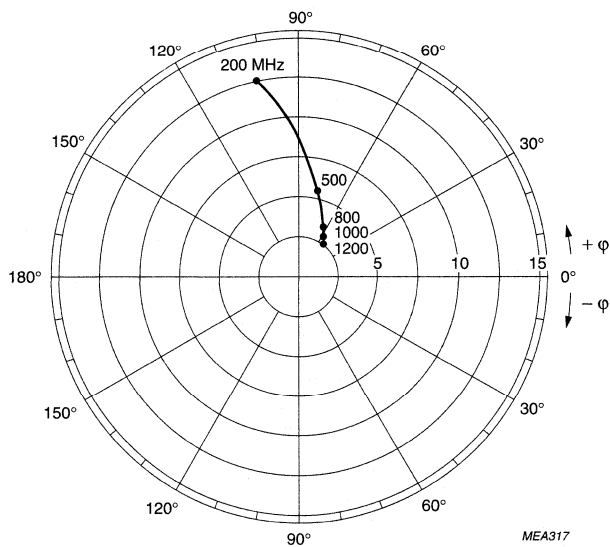
NPN 4 GHz wideband transistor

BFQ34



$I_c = 120 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_o = 50 \text{ } \Omega$.

Fig.8 Common emitter input reflection coefficient (S_{11}).

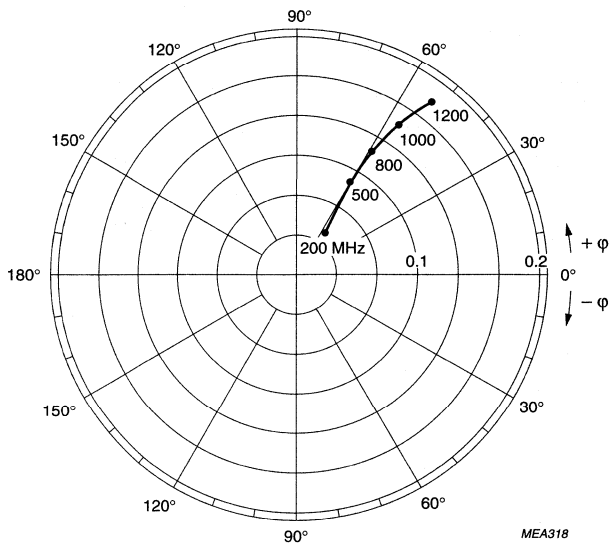


$I_c = 120 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.9 Common emitter forward transmission coefficient (S_{21}).

NPN 4 GHz wideband transistor

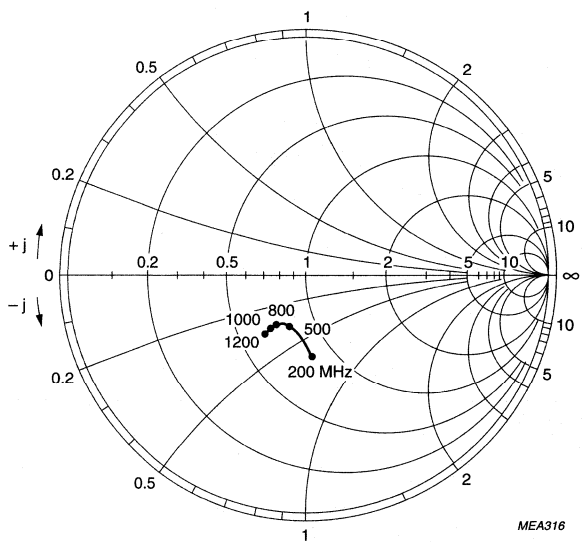
BFQ34



$I_c = 120 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

MEA318

Fig.10 Common emitter reverse transmission coefficient (S_{12}).



$I_c = 120 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_0 = 50 \Omega$.

MEA316

Fig.11 Common emitter output reflection coefficient (S_{22}).

NPN 8 GHz wideband transistor

BFQ67

FEATURES

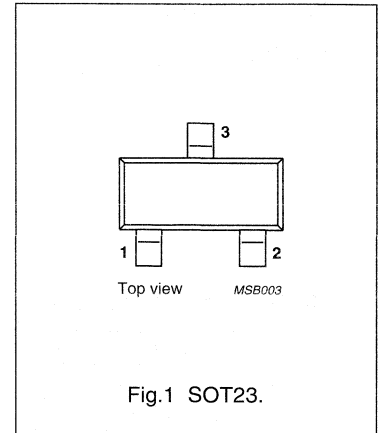
- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |

DESCRIPTION

Silicon NPN transistor in a plastic SOT23 envelope. It is designed for wideband applications such as satellite TV tuners and RF portable communications equipment up to 2 GHz.



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 10 | V |
| I_C | DC collector current | | – | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 97\text{ }^\circ\text{C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = 15\text{ mA}$; $V_{CE} = 5\text{ V}$ | 60 | 100 | – | |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$ | – | 8 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$ | – | 14 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$ | – | 1.3 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|---|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 97\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature range | | –65 | 150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 175 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 8 GHz wideband transistor

BFQ67

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 260 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 5\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 15\text{ mA}; V_{CE} = 5\text{ V}$ | 60 | 100 | – | |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 8\text{ V}; f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 1.3 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 8\text{ V}; f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}; V_{CE} = 8\text{ V}$ | – | 8 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 15\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ °C}; f = 1\text{ GHz}$ | – | 14 | – | dB |
| | | $I_C = 15\text{ mA}; V_{CE} = 8\text{ V}; f = 2\text{ GHz}$ | – | 8 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ °C}; f = 1\text{ GHz}$ | – | 1.3 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 15\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ °C}; f = 1\text{ GHz}$ | – | 1.7 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ °C}; f = 2\text{ GHz}$ | – | 2.2 | – | dB |
| | | $I_C = 5\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ °C}; f = 2\text{ GHz}; Z_s = 60\ \Omega$ | – | 2.5 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 15\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ °C}; f = 2\text{ GHz}$ | – | 2.7 | – | dB |
| | | $I_C = 15\text{ mA}; V_{CE} = 8\text{ V}; T_{amb} = 25\text{ °C}; f = 2\text{ GHz}; Z_s = 60\ \Omega$ | – | 3 | – | dB |

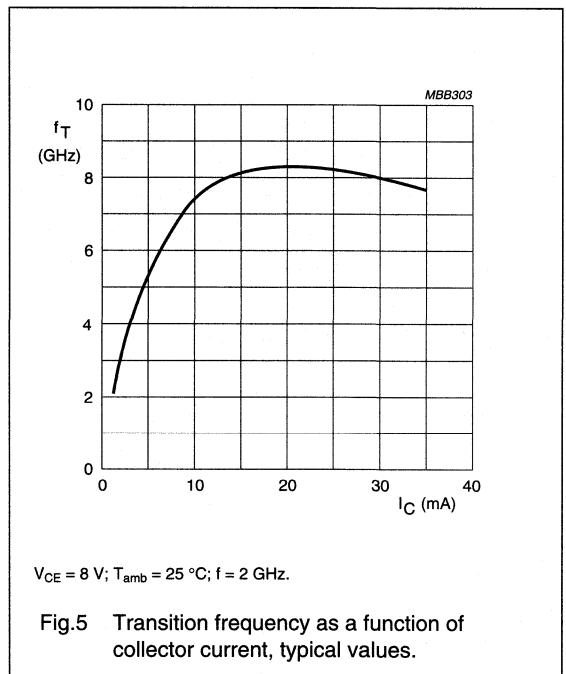
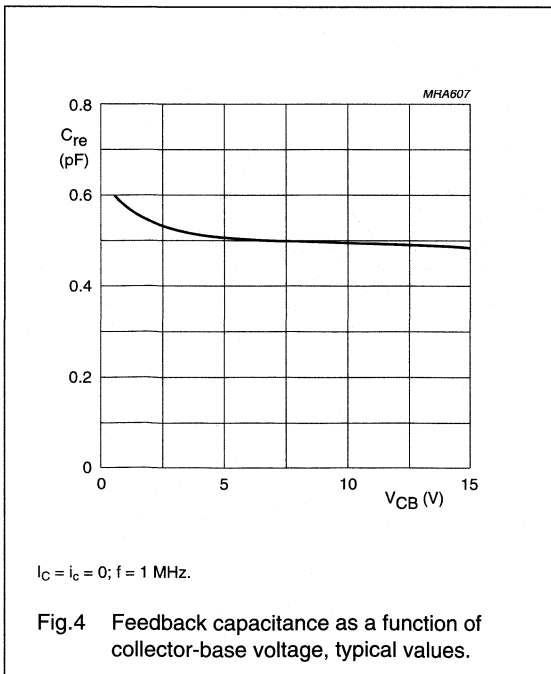
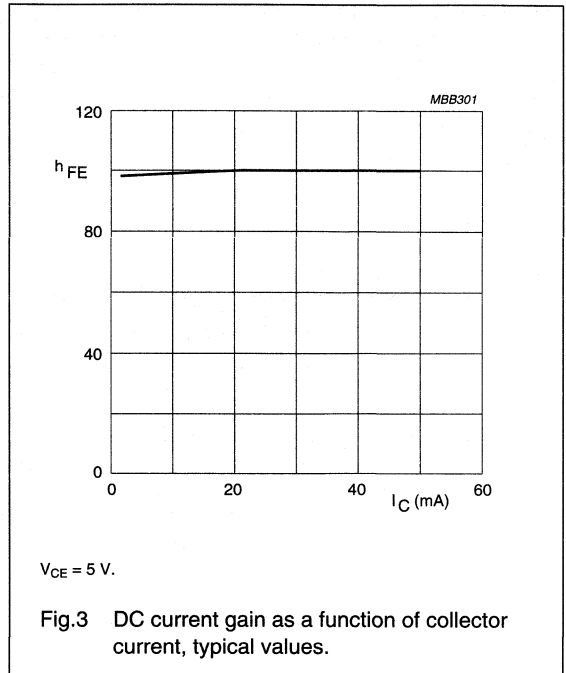
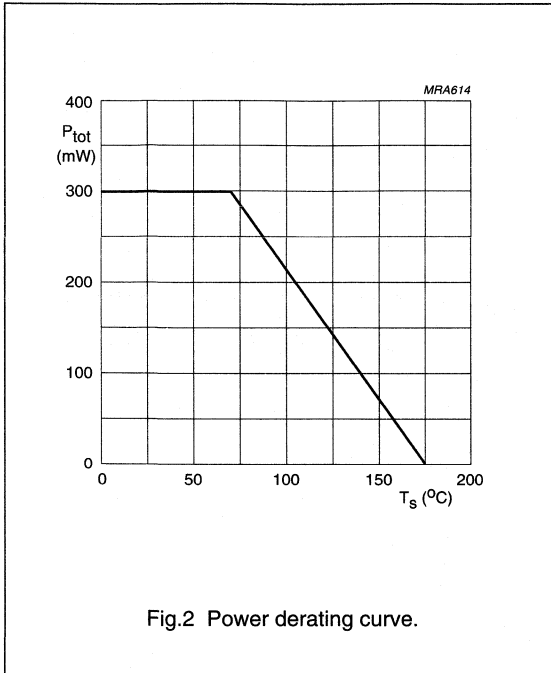
Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

NPN 8 GHz wideband transistor

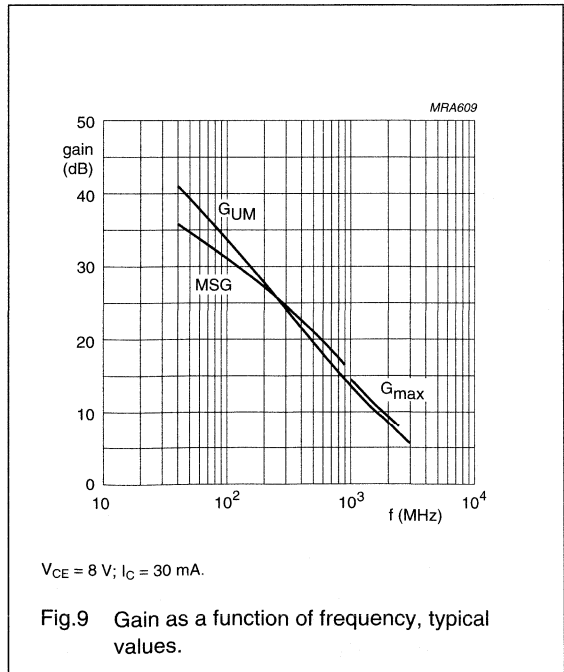
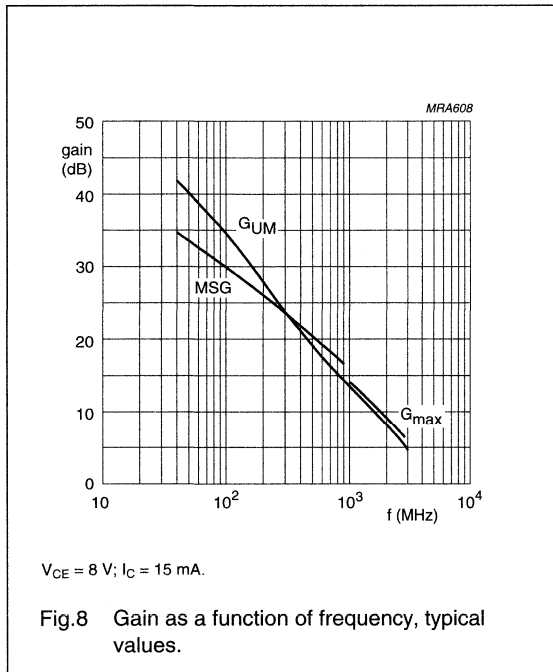
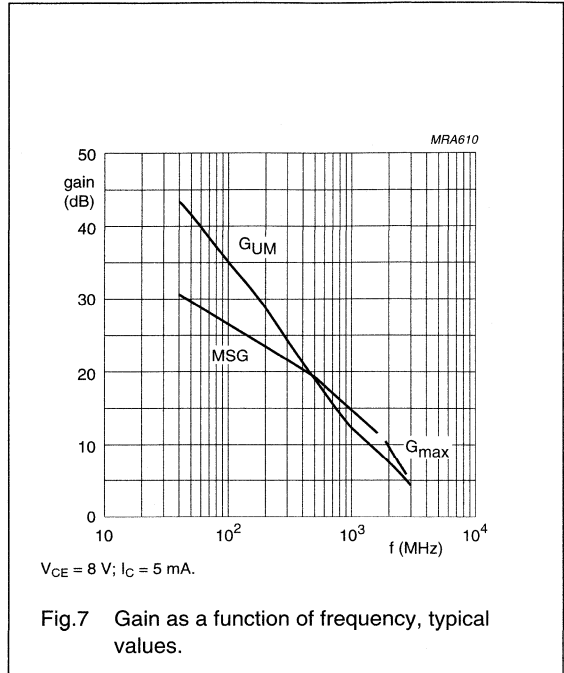
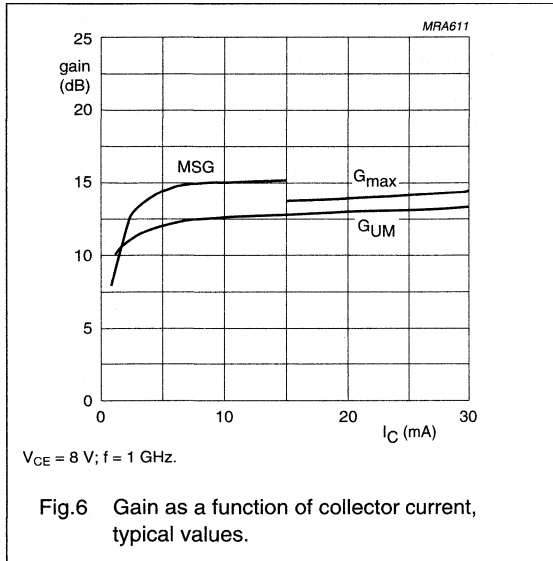
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NPN 8 GHz wideband transistor

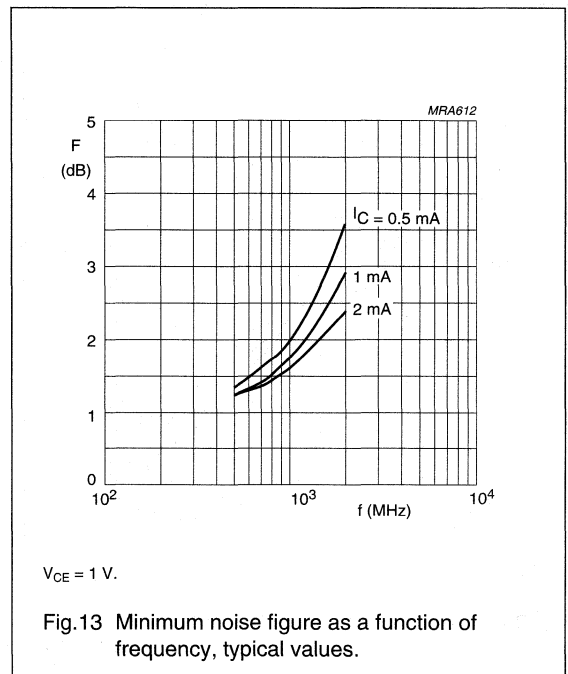
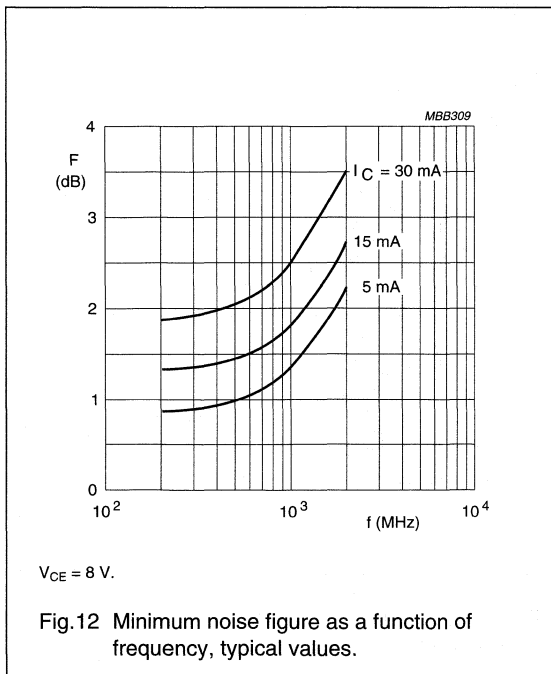
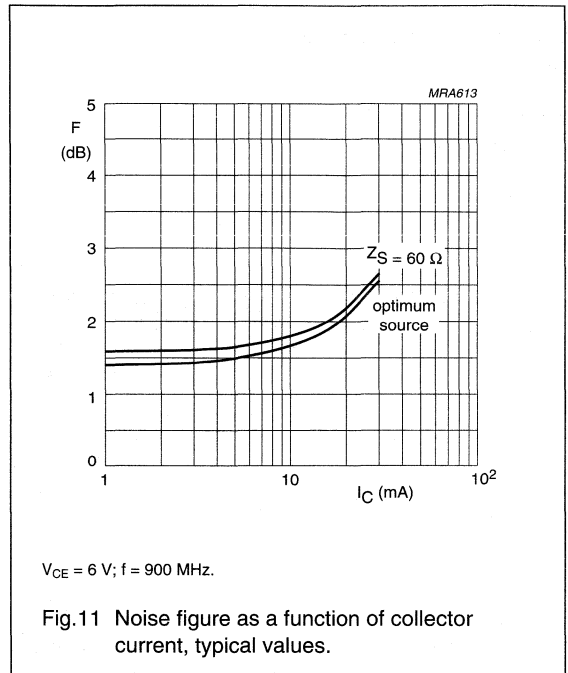
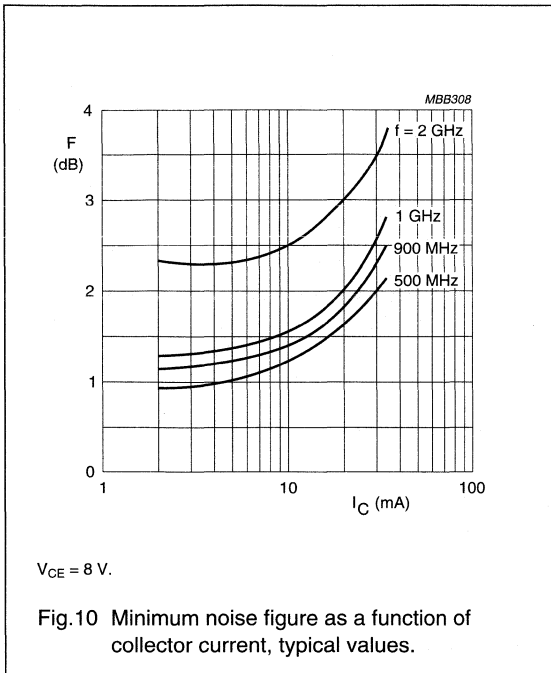
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In Figs 6 to 9, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



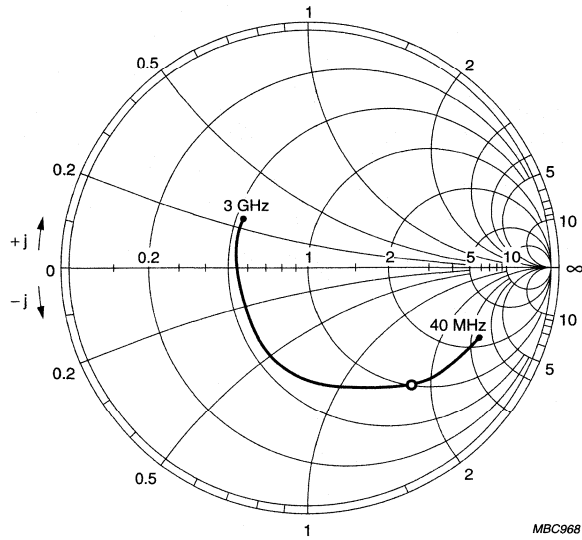
NPN 8 GHz wideband transistor

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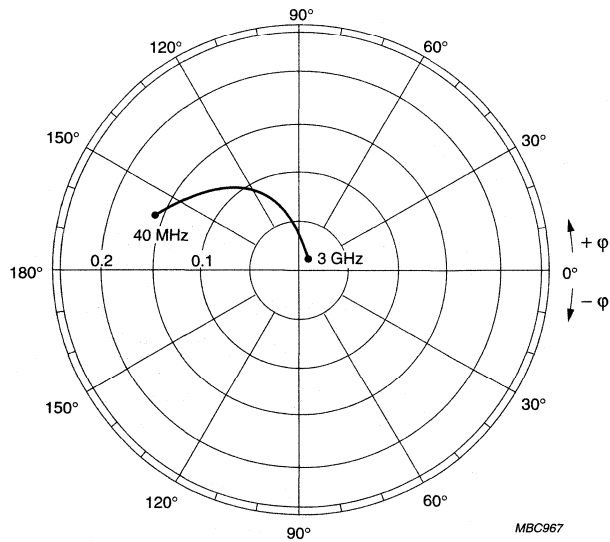
NPN 8 GHz wideband transistor

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$V_{CE} = 8 \text{ V}; I_C = 15 \text{ mA}.$
 $Z_o = 50 \Omega.$

Fig.14 Common emitter input reflection coefficient (S_{11}), typical values.

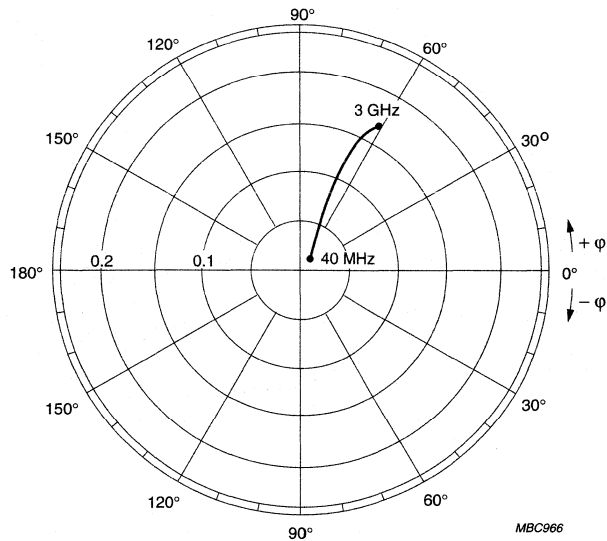


$V_{CE} = 8 \text{ V}; I_C = 15 \text{ mA}.$

Fig.15 Common emitter forward transmission coefficient (S_{21}), typical values.

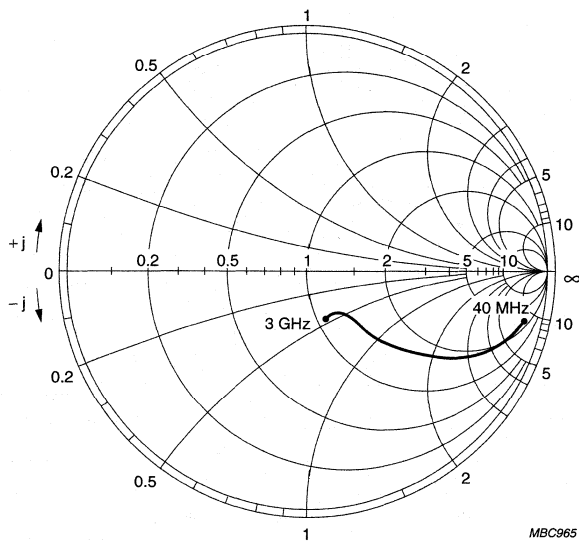
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$V_{CE} = 8 \text{ V}; I_C = 15 \text{ mA}$.

Fig.16 Common emitter reverse transmission coefficient (S_{12}), typical values.



$V_{CE} = 8 \text{ V}; I_C = 15 \text{ mA}$.
 $Z_0 = 50 \Omega$.

Fig.17 Common emitter output reflection coefficient (S_{22}), typical values.

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FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability
- SOT323 envelope.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: V2 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |

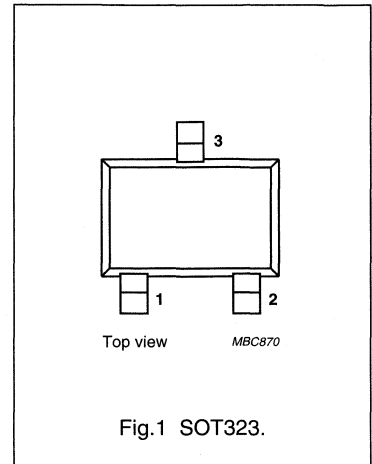


Fig.1 SOT323.

DESCRIPTION

NPN transistor in a plastic SOT323 envelope.

It is designed for wideband applications such as satellite TV tuners and RF portable communications equipment up to 2 GHz.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 10 | V |
| I_C | DC collector current | | – | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ }^\circ\text{C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = 15\text{ mA}$; $V_{CE} = 5\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$ | 60 | 100 | – | |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 8 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 13 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$ | – | 1.3 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | 150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 175 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector tab.

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THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 118\text{ °C}$; note 1 | 190 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$, unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 5\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 15\text{ mA}$; $V_{CE} = 5\text{ V}$ | 60 | 100 | – | |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.3 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 8 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| | | $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 8 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$ | – | 1.3 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$ | – | 2 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$ | – | 2.2 | – | dB |
| | | $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $Z_s = 60\ \Omega$ | – | 2.5 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 15\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$ | – | 2.7 | – | dB |
| | | $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $Z_s = 60\ \Omega$ | – | 3 | – | dB |

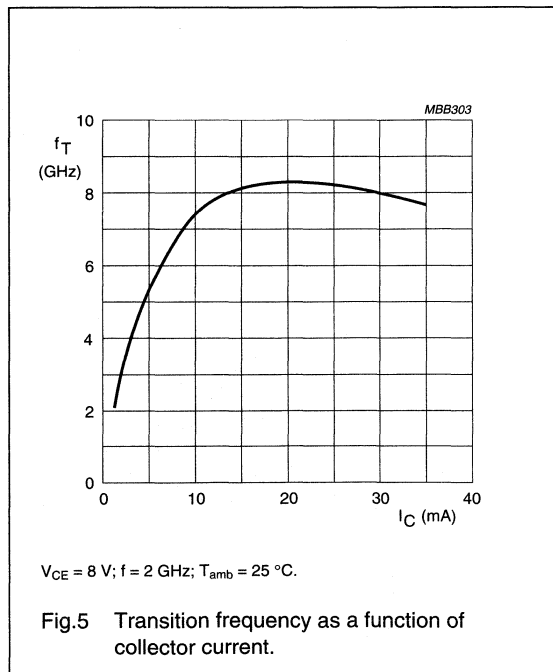
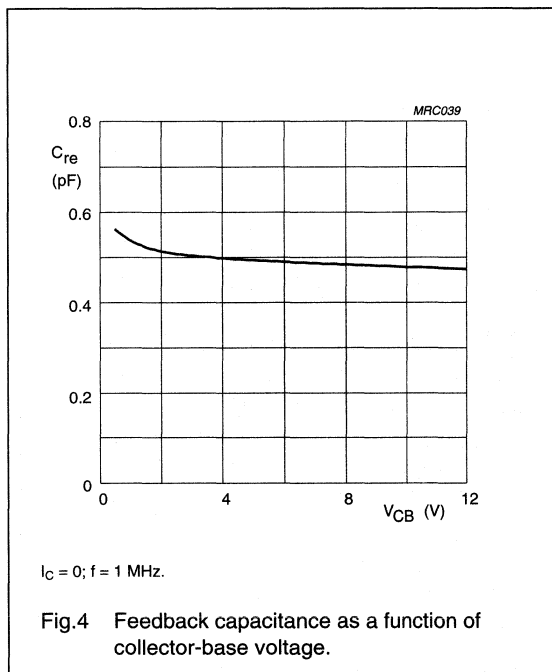
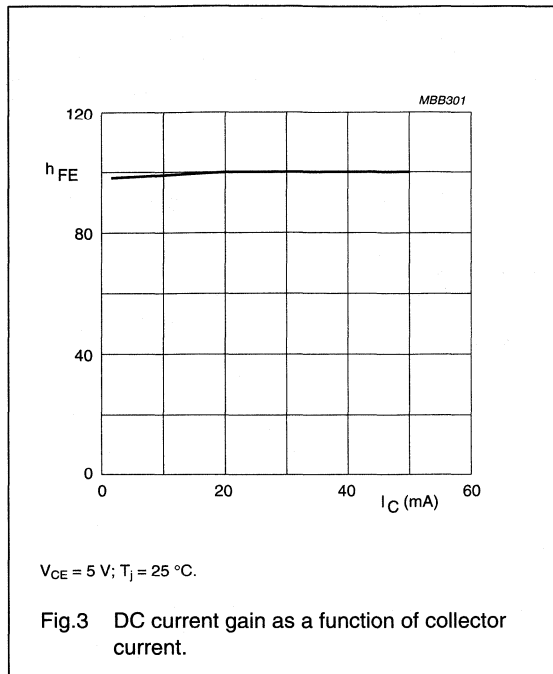
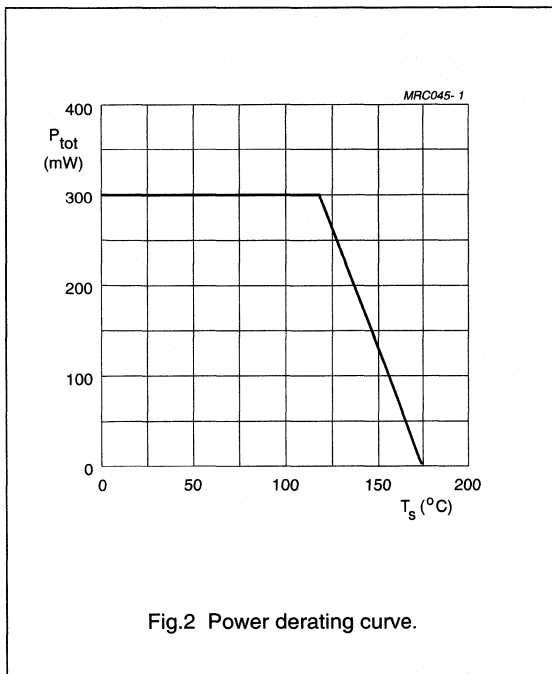
Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

NPN 8 GHz wideband transistor

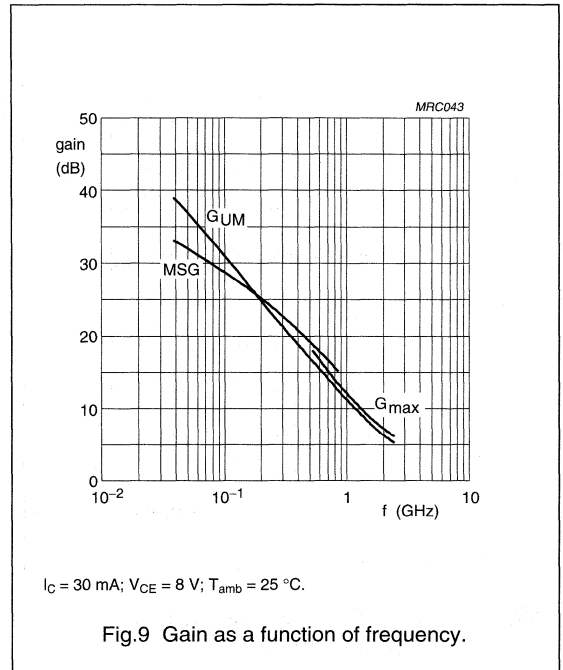
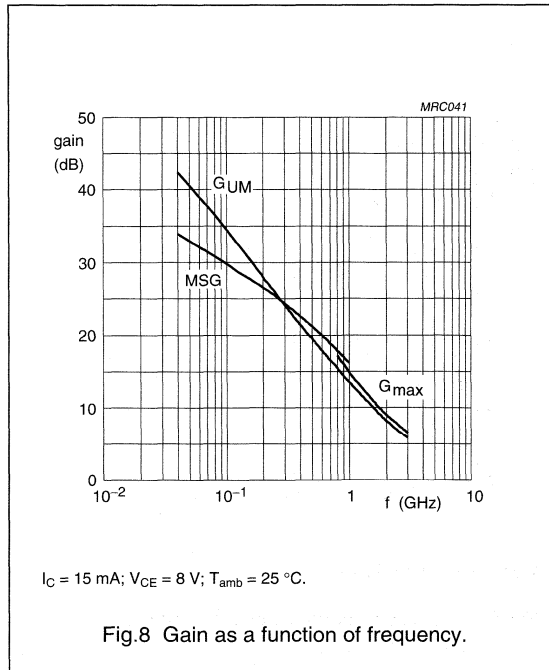
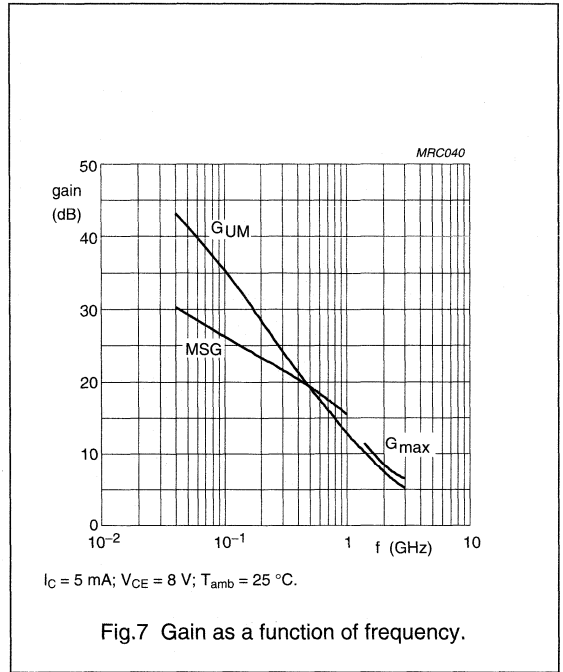
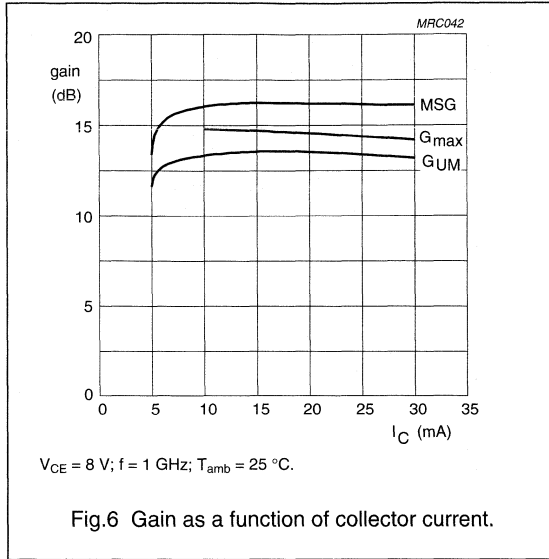
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NPN 8 GHz wideband transistor

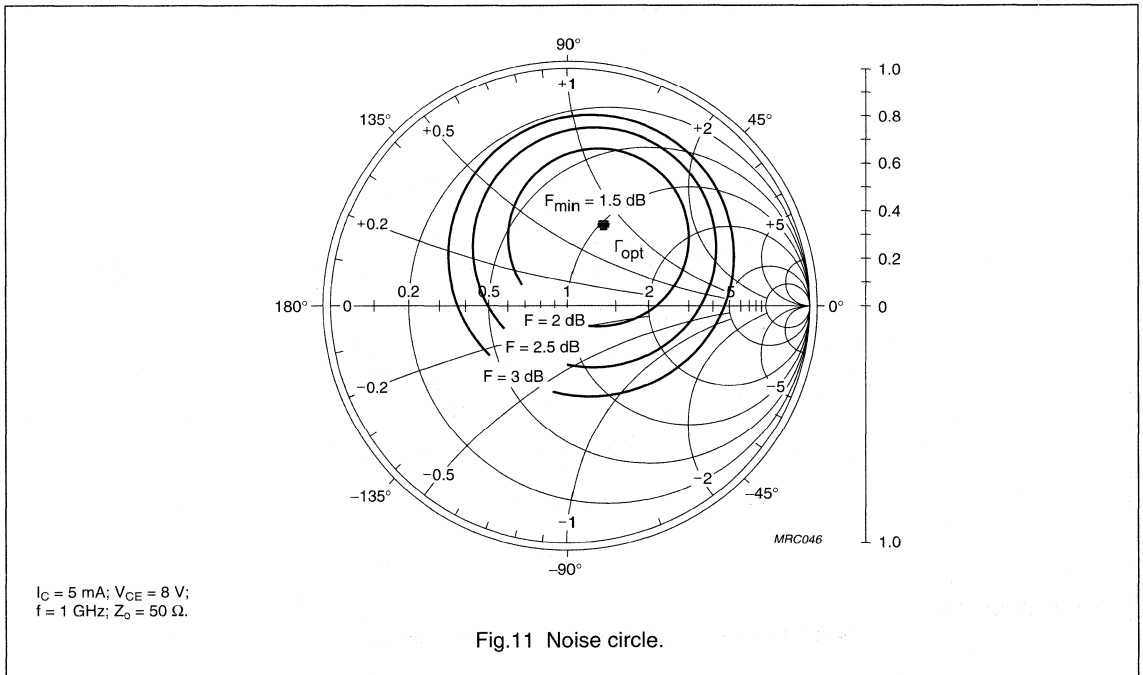
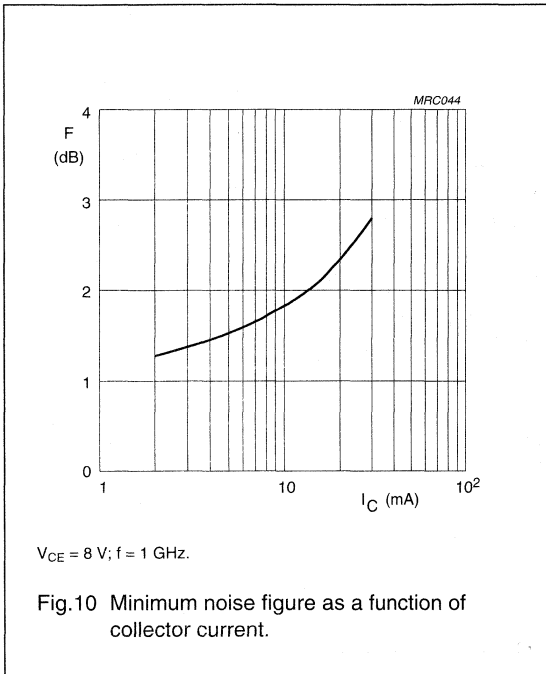
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In Figs 6 to 9, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



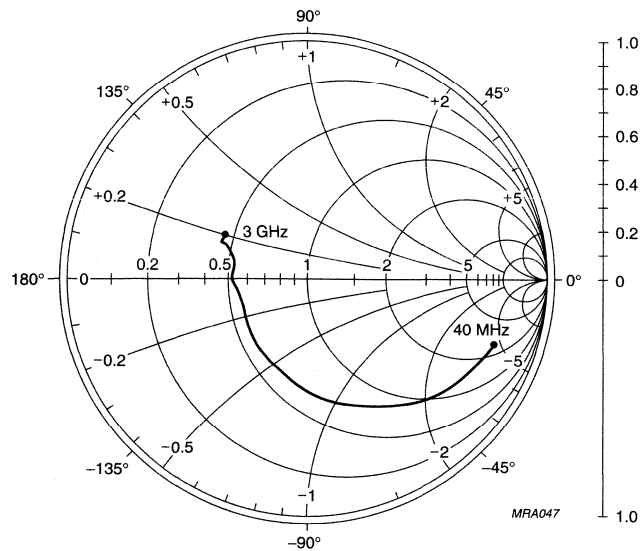
NPN 8 GHz wideband transistor

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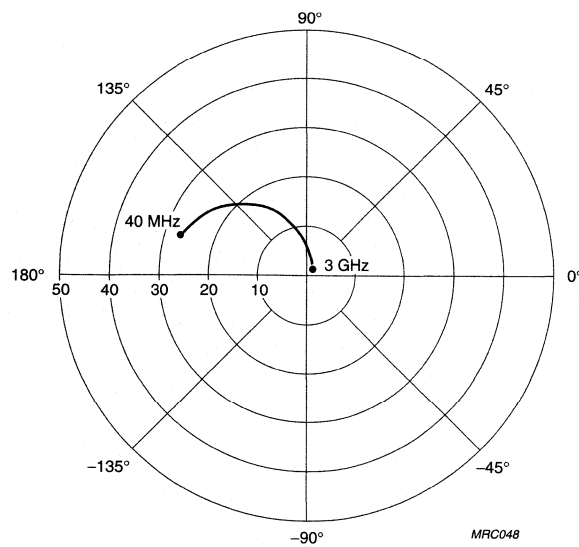
NPN 8 GHz wideband transistor

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$I_C = 15 \text{ mA}; V_{CE} = 8 \text{ V}; Z_0 = 50 \Omega.$

Fig.12 Common emitter input reflection coefficient (S_{11}).

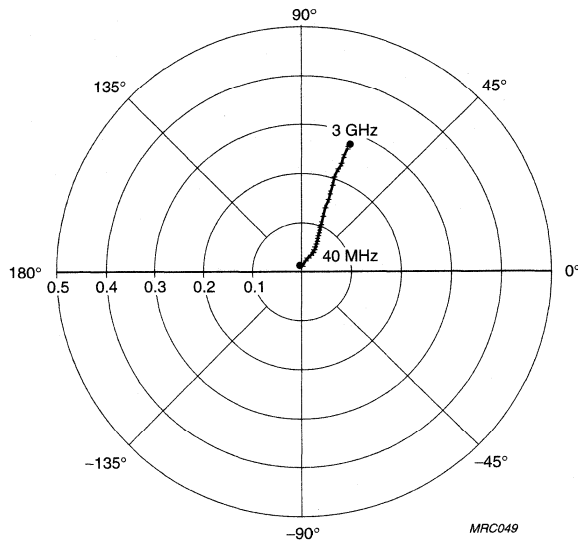


$I_C = 15 \text{ mA}; V_{CE} = 8 \text{ V}.$

Fig.13 Common emitter forward transmission coefficient (S_{21}).

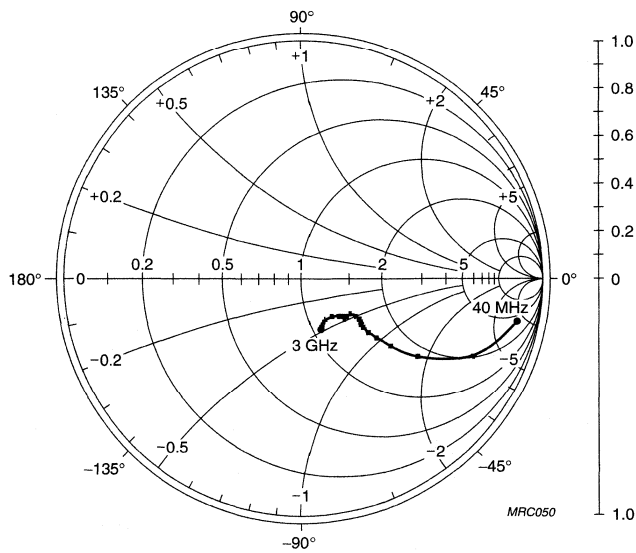
NPN 8 GHz wideband transistor

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$I_C = 15 \text{ mA}$; $V_{CE} = 8 \text{ V}$.

Fig.14 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 15 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $Z_0 = 50 \Omega$.

Fig.15 Common emitter output reflection coefficient (S_{22}).

NPN 4 GHz wideband transistor

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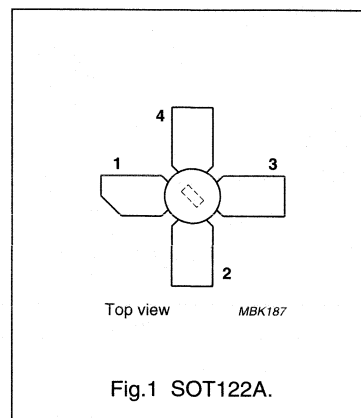
DESCRIPTION

NPN transistor mounted in a four-lead dual-emitter SOT122A envelope with a ceramic cap. All leads are isolated from the stud. Diffused emitter-ballasting resistors and the application of gold sandwich metallization ensure an optimum temperature profile and excellent reliability properties. It features very high output voltage capabilities.

It is primarily intended for final stages in MATV system amplifiers, and is also suitable for use in low power band IV and V equipment.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|---------------------------------------|---|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | – | 18 | V |
| I_C | collector current | | – | 300 | mA |
| P_{tot} | total power dissipation | up to $T_c = 110\text{ °C}$ | – | 4.5 | W |
| f_T | transition frequency | $I_C = 240\text{ mA}$; $V_{CE} = 15\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ °C}$ | 4 | – | GHz |
| V_o | output voltage | $I_C = 240\text{ mA}$; $V_{CE} = 15\text{ V}$; $d_{im} = -60\text{ dB}$; $R_L = 75\text{ }\Omega$; $f_{(p+q-r)} = 793.25\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 1.6 | – | V |
| PL_1 | output power at 1 dB gain compression | $I_C = 240\text{ mA}$; $V_{CE} = 15\text{ V}$; $R_L = 75\text{ }\Omega$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 28 | – | dBm |
| ITO | third order intercept point | $I_C = 240\text{ mA}$; $V_{CE} = 15\text{ V}$; $R_L = 75\text{ }\Omega$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 47 | – | dBm |

WARNING

Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

NPN 4 GHz wideband transistor

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LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-----------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 18 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 300 | mA |
| P_{tot} | total power dissipation | up to $T_c = 110\text{ °C}$ | – | 4.5 | W |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 200 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|--|--------------------|
| $R_{th\ j-c}$ | thermal resistance from junction to case | 20 K/W |

NPN 4 GHz wideband transistor

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CHARACTERISTICST_j = 25 °C unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------|--|---|------|------|------|------|
| I _{CBO} | collector cut-off current | I _E = 0; V _{CB} = 15 V | – | – | 50 | μA |
| h _{FE} | DC current gain | I _C = 240 mA; V _{CE} = 15 V | 25 | 75 | – | |
| f _T | transition frequency | I _C = 240 mA; V _{CE} = 15 V; f = 500 MHz | – | 4 | – | GHz |
| C _c | collector capacitance | I _E = i _e = 0; V _{CB} = 15 V; f = 1 MHz | – | 3.8 | – | pF |
| C _e | emitter capacitance | I _C = i _c = 0; V _{EB} = 0.5 V; f = 1 MHz | – | 20 | – | pF |
| C _{re} | feedback capacitance | I _C = 0; V _{CE} = 15 V; f = 1 MHz | – | 2.3 | – | pF |
| C _{cs} | collector-stud capacitance | note 1 | – | 0.8 | – | pF |
| G _{UM} | maximum unilateral power gain (note 2) | I _C = 240 mA; V _{CE} = 15 V; f = 800 MHz; T _{amb} = 25 °C | – | 13 | – | dB |
| V _o | output voltage | note 3 | – | 1.6 | – | V |
| P _{L1} | output power at 1 dB gain compression (see Fig.2) | I _C = 240 mA; V _{CE} = 15 V; R _L = 75 Ω; T _{amb} = 25 °C; measured at f = 800 MHz | – | 28 | – | dBm |
| ITO | third order intercept point (see Fig.2) | note 4 | – | 47 | – | dBm |

Notes

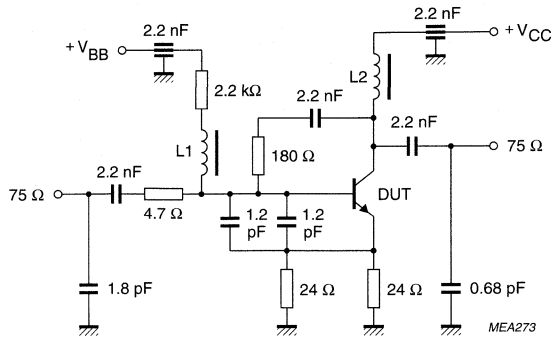
1. Measured with emitter and base grounded.
2. G_{UM} is the maximum unilateral power gain, assuming S₁₂ is zero and

$$G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \text{ dB.}$$

3. d_{im} = –60 dB (see Figs 2 and 7) (DIN 45004B); I_C = 240 mA; V_{CE} = 15 V; R_L = 75 Ω; T_{amb} = 25 °C;
V_p = V_o at d_{im} = –60 dB; f_p = 795.25 MHz;
V_q = V_o –6 dB; f_q = 803.25 MHz;
V_r = V_o –6 dB; f_r = 805.25 MHz;
measured at f_(p+q-r) = 793.25 MHz.
4. I_C = 240 mA; V_{CE} = 15 V; R_L = 75 Ω; T_{amb} = 25 °C;
P_p = ITO – 6 dB; f_p = 800 MHz;
P_q = ITO – 6 dB; f_q = 801 MHz;
measured at f_(2q-p) = 802 MHz and at f_(2p-q) = 799 MHz.

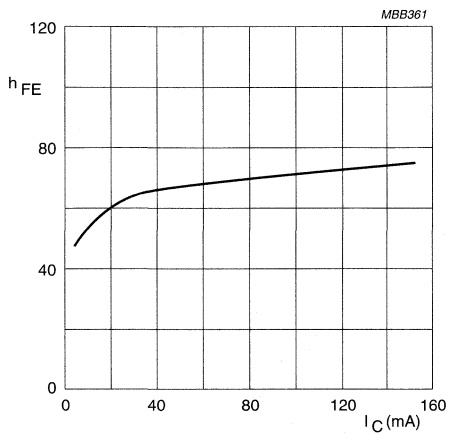
NPN 4 GHz wideband transistor

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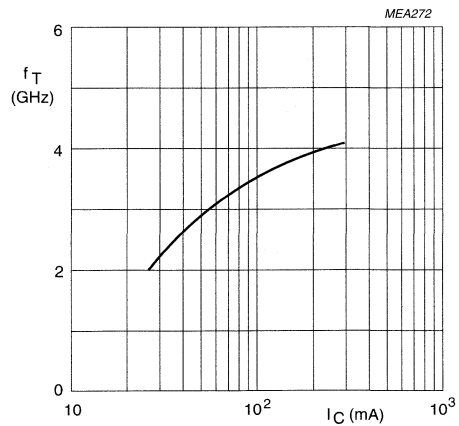
f = 40 to 860 MHz.
L1 = L2 = 5 μH Ferroxcube choke.

Fig.2 Intermodulation distortion MATV test circuit.



V_{CE} = 10 V; T_J = 25 °C.

Fig.3 DC current gain as a function of collector current.

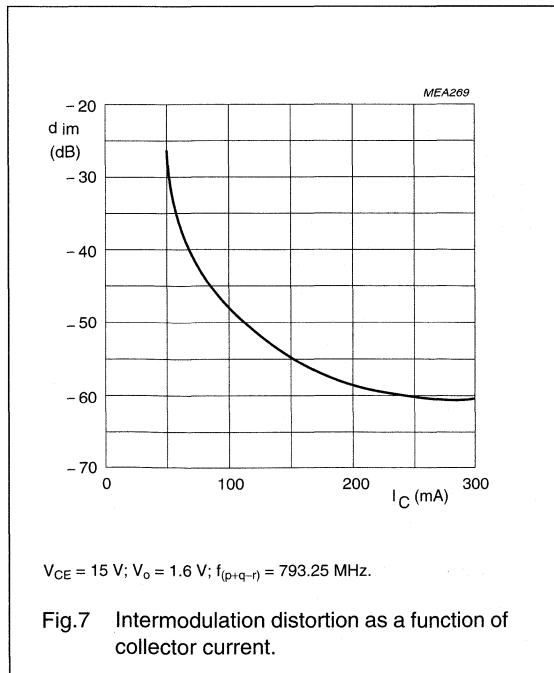
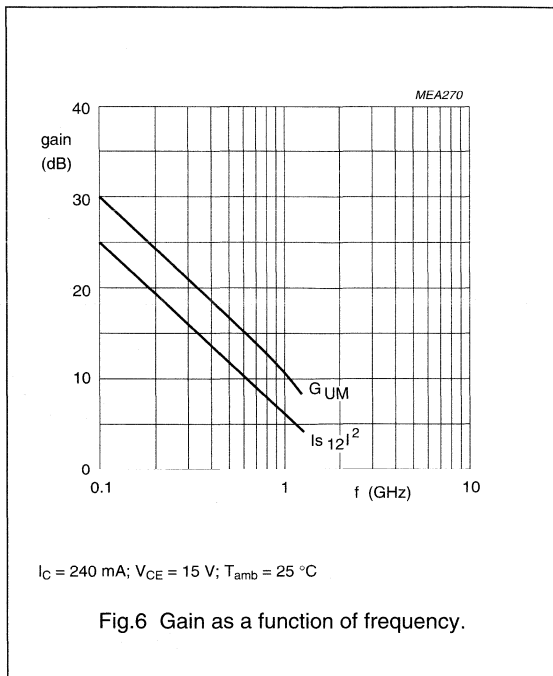
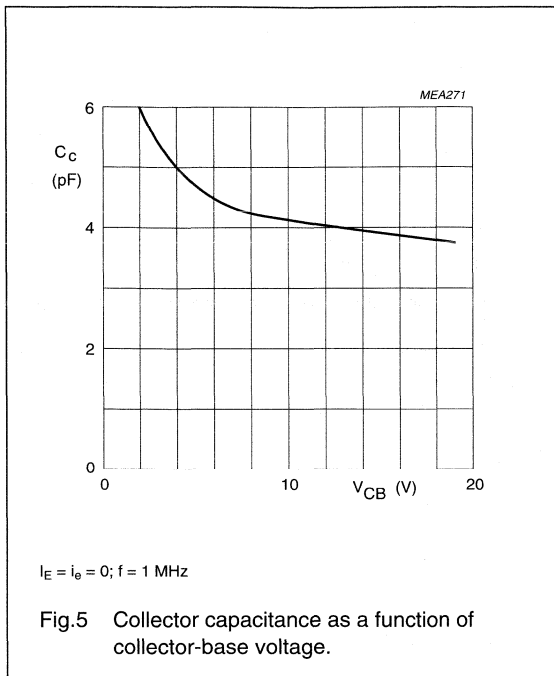


V_{CE} = 15 V; f = 500 MHz; T_J = 25 °C

Fig.4 Transition frequency as a function of collector current.

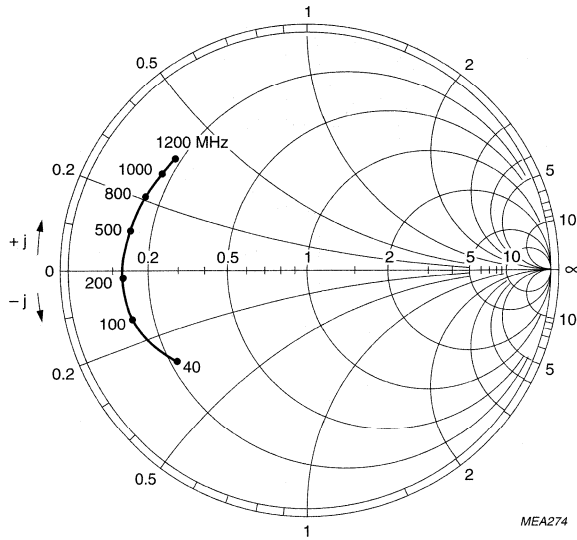
NPN 4 GHz wideband transistor

BFQ68



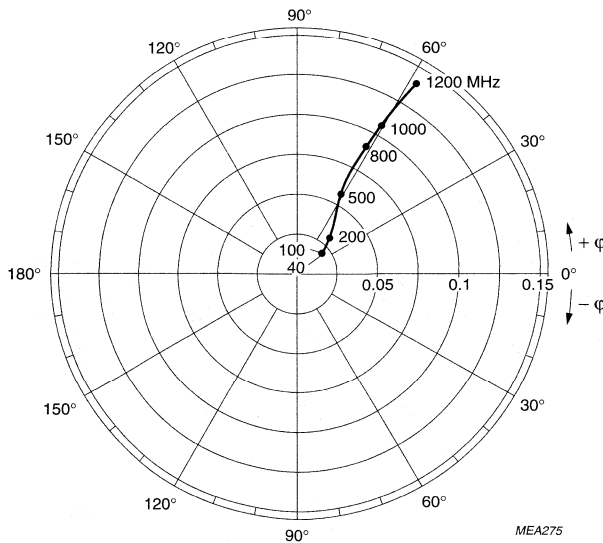
NPN 4 GHz wideband transistor

BFQ68



$I_C = 240 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_0 = 50 \text{ } \Omega$.

Fig.8 Common emitter input reflection coefficient (S_{11}).

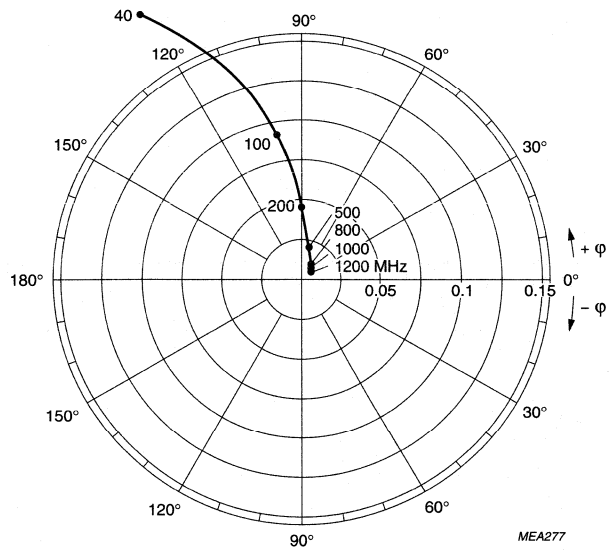


$I_C = 240 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.9 Common emitter forward transmission coefficient (S_{21}).

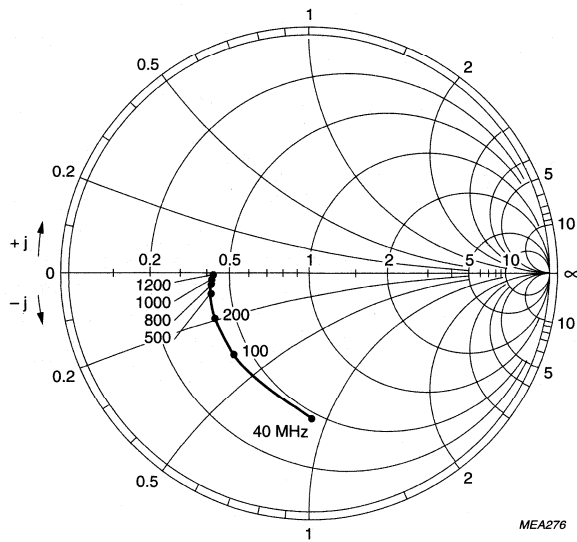
NPN 4 GHz wideband transistor

BFQ68



$I_C = 240 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.10 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 240 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_0 = 50 \text{ } \Omega$.

Fig.11 Common emitter output reflection coefficient (S_{22}).

NPN 6.5 GHz wideband transistor

BFQ135

FEATURES

- Optimum temperature profile and excellent reliability properties ensured by emitter-ballasting resistors and application of gold sandwich metallization.

APPLICATIONS

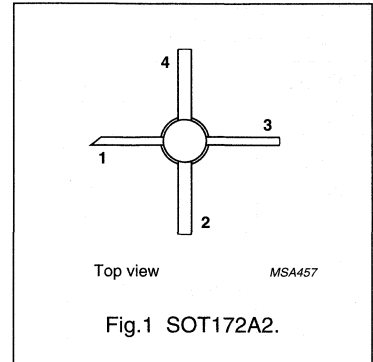
- MATV and microwave amplifiers, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analysers, etc.

DESCRIPTION

NPN wideband transistor in a 4-lead dual-emitter SOT172A2 package with a ceramic cap. All leads are isolated from the mounting base.

PINNING

| PIN | DESCRIPTION |
|------|-------------|
| 1 | collector |
| 2, 4 | emitter |
| 3 | base |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | – | – | 19 | V |
| I_C | collector current (DC) | | – | – | 150 | mA |
| P_{tot} | total power dissipation | $T_c \leq 145\text{ }^\circ\text{C}$ | – | – | 2.7 | W |
| h_{FE} | DC current gain | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}$ | 55 | – | – | |
| f_T | transition frequency | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; f = 1\text{ GHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 6.5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 17 | – | dB |
| | | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; f = 800\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 13.5 | – | dB |
| V_O | output voltage | $d_{im} = -60\text{ dB}; I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; R_L = 75\text{ }\Omega; f_p + f_q - f_r = 793.25\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1.2 | – | V |

WARNING

Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

NPN 6.5 GHz wideband transistor

BFQ135

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 19 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | collector current (DC) | | – | 150 | mA |
| P_{tot} | total power dissipation | $T_c \leq 145\text{ °C}$ | – | 2.7 | W |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 200 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | VALUE | UNIT |
|---------------|--|-------|------|
| $R_{th\ j-c}$ | thermal resistance from junction to case | 20 | K/W |

NPN 6.5 GHz wideband transistor

BFQ135

CHARACTERISTICS

 $T_j = 25\text{ °C}$ unless otherwise specified.

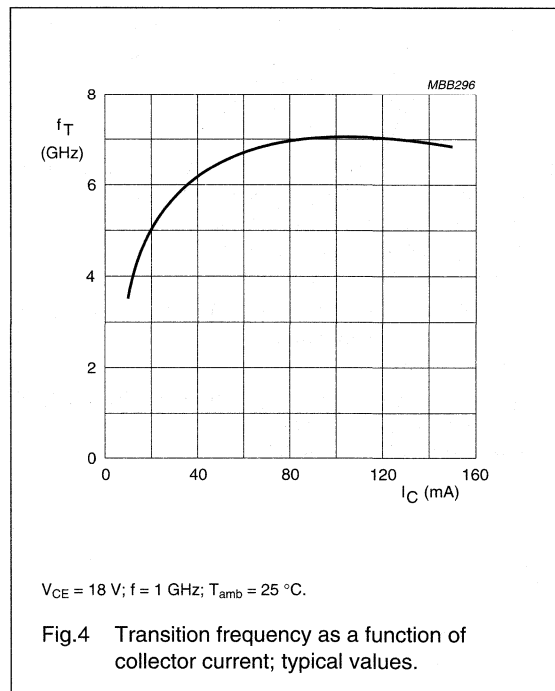
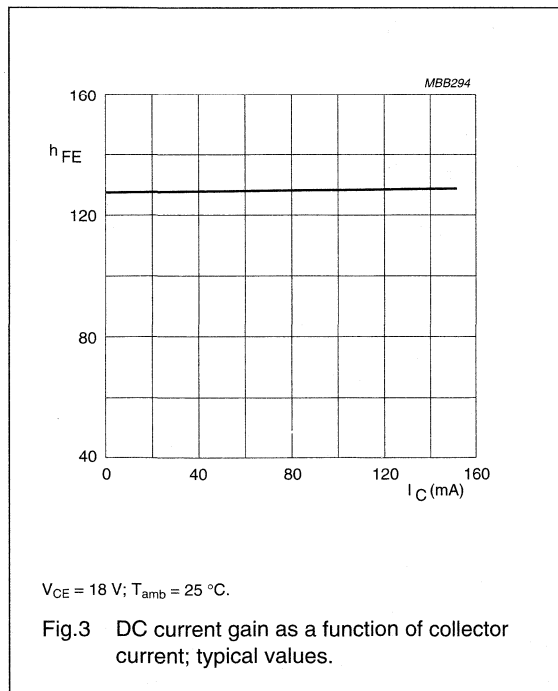
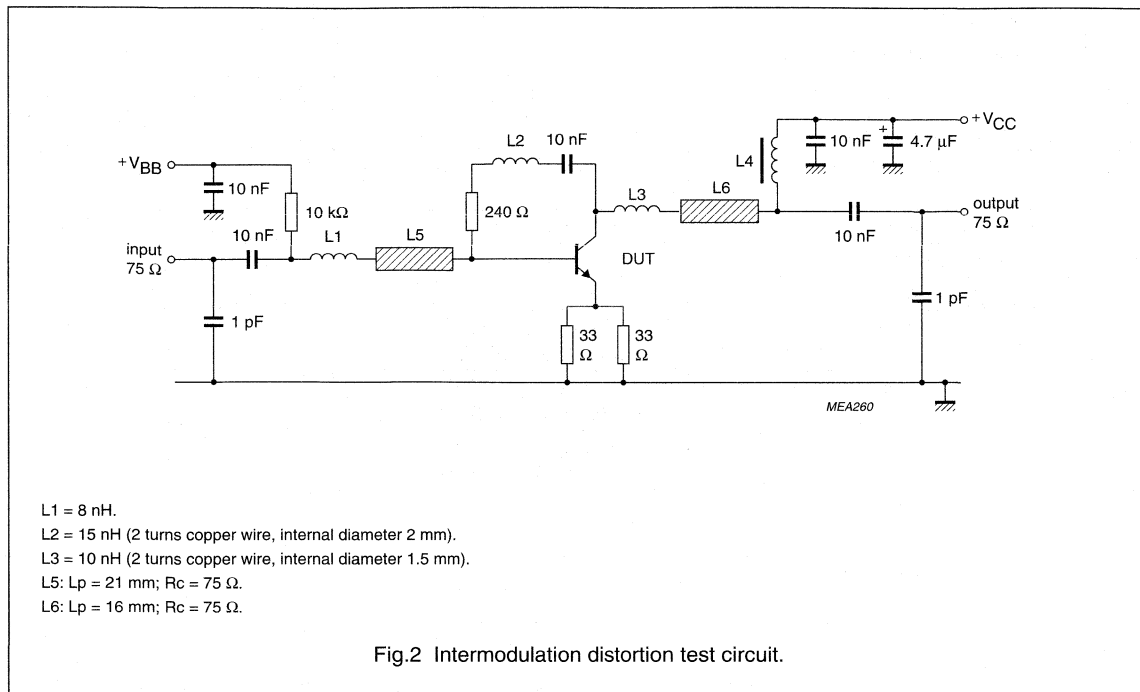
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|---------------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 18\text{ V}$ | – | – | 50 | μA |
| h_{FE} | DC current gain | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; T_{amb} = 25\text{ °C}$ | 55 | – | – | |
| C_c | collector capacitance | $I_E = I_C = 0; V_{CB} = 18\text{ V}; f = 1\text{ MHz}$ | – | 1.8 | – | pF |
| C_e | emitter capacitance | $I_C = I_C = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 5.5 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = 18\text{ V}; f = 1\text{ MHz}$ | – | 1 | 1.2 | pF |
| f_T | transition frequency | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; f = 1\text{ GHz}; T_{amb} = 25\text{ °C}$ | – | 6.5 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 17 | – | dB |
| | | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; f = 800\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 13.5 | – | dB |
| V_O | output voltage | note 2 | – | 1.35 | – | V |
| | | note 3 | – | 1.2 | – | V |
| d_2 | second order intermodulation distortion | note 4 | – | –70 | – | dB |
| | | note 5 | – | –70 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right)$ dB.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; R_L = 75\ \Omega; T_{amb} = 25\text{ °C};$
 $V_p = V_O$ at $d_{im} = -60\text{ dB}; f_p = 445.25\text{ MHz};$
 $V_q = V_O - 6\text{ dB}; f_q = 453.25\text{ MHz};$
 $V_r = V_O - 6\text{ dB}; f_r = 455.25\text{ MHz};$
measured at $f_p + f_q - f_r = 443.25\text{ MHz}.$
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; R_L = 75\ \Omega; T_{amb} = 25\text{ °C};$
 $V_p = V_O$ at $d_{im} = -60\text{ dB}; f_p = 795.25\text{ MHz};$
 $V_q = V_O - 6\text{ dB}; f_q = 803.25\text{ MHz};$
 $V_r = V_O - 6\text{ dB}; f_r = 805.25\text{ MHz};$
measured at $f_p + f_q - f_r = 793.25\text{ MHz}.$
- $I_C = 90\text{ mA}; V_{CE} = 18\text{ V}; V_O = 50\text{ dBmV}; T_{amb} = 25\text{ °C};$
 $f_p = 50\text{ MHz}; f_q = 400\text{ MHz};$
measured at $f_p + f_q = 450\text{ MHz}.$
- $I_C = 90\text{ mA}; V_{CE} = 18\text{ V}; V_O = 50\text{ dBmV}; T_{amb} = 25\text{ °C};$
 $f_p = 250\text{ MHz}; f_q = 560\text{ MHz};$
measured at $f_p + f_q = 810\text{ MHz}.$

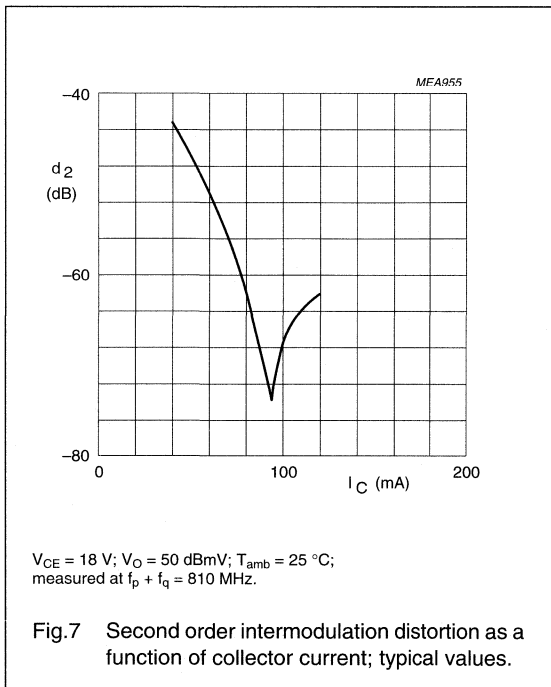
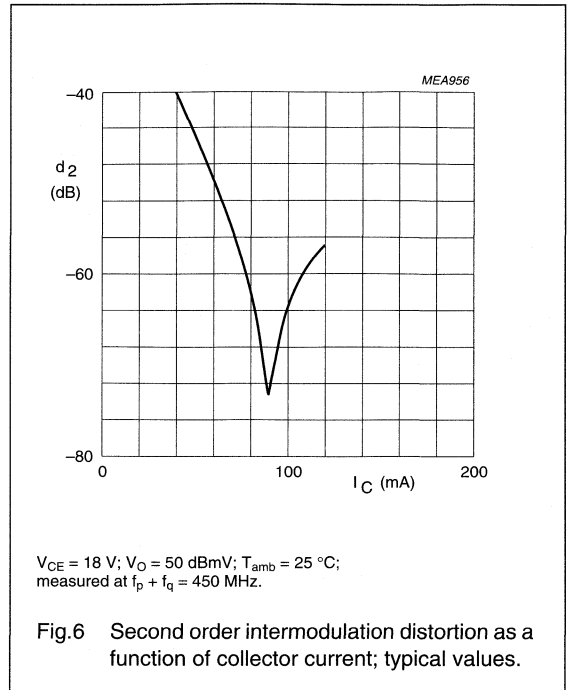
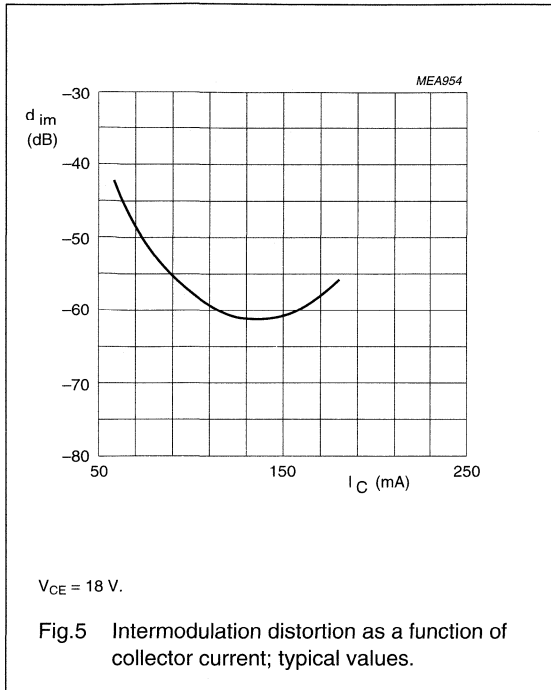
NPN 6.5 GHz wideband transistor

BFQ135



NPN 6.5 GHz wideband transistor

BFQ135



NPN 4 GHz wideband transistor

BFQ136

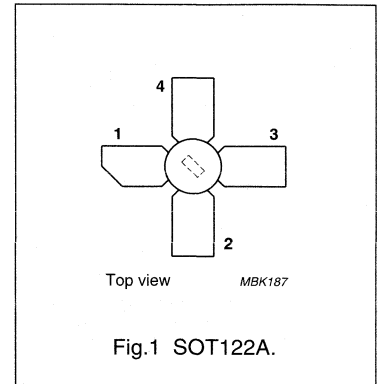
DESCRIPTION

NPN transistor in a four-lead dual-emitter SOT122A envelope with a ceramic cap. All leads are isolated from the stud. Diffused emitter-ballasting resistors and the application of gold sandwich metallization ensure an optimum temperature profile and excellent reliability properties. It features extremely high output voltage capabilities.

It is primarily intended for final stages in UHF amplifiers.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | – | 18 | V |
| I_C | DC collector current | | – | 600 | mA |
| P_{tot} | total power dissipation | up to $T_c = 100\text{ }^\circ\text{C}$ | – | 9 | W |
| f_T | transition frequency | $I_C = 500\text{ mA}$; $V_{CE} = 15\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ }^\circ\text{C}$ | 4.0 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 500\text{ mA}$; $V_{CE} = 15\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 12.5 | – | dB |
| V_o | output voltage | $I_C = 500\text{ mA}$; $V_{CE} = 15\text{ V}$; $d_{im} = -60\text{ dB}$; $R_L = 75\text{ }\Omega$; $f_{(p+q-r)} = 793.25\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 2.5 | – | V |

WARNING

Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

NPN 4 GHz wideband transistor

BFQ136

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|---------------------------|-------------------------------|------|------|------|
| V _{CB0} | collector-base voltage | open emitter | – | 25 | V |
| V _{CEO} | collector-emitter voltage | open base | – | 18 | V |
| V _{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I _C | DC collector current | | – | 600 | mA |
| P _{tot} | total power dissipation | up to T _c = 100 °C | – | 9 | W |
| T _{stg} | storage temperature | | –65 | 150 | °C |
| T _j | junction temperature | | – | 200 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------------|--|--------------------|
| R _{th j-c} | thermal resistance from junction to case | 11 K/W |

CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------|--|---|------|------|------|------|
| I _{CB0} | collector cut-off current | I _E = 0; V _{CB} = 15 V | – | – | 75 | μA |
| h _{FE} | DC current gain | I _C = 500 mA; V _{CE} = 15 V | 25 | 75 | – | |
| C _c | collector capacitance | I _E = i _e = 0; V _{CB} = 15 V; f = 1 MHz | – | 7.0 | – | pF |
| C _e | emitter capacitance | I _C = i _c = 0; V _{EB} = 0.5 V; f = 1 MHz | – | 40 | – | pF |
| C _{re} | feedback capacitance | I _C = 0; V _{CE} = 15 V; f = 1 MHz | – | 4.0 | – | pF |
| C _{cs} | collector-stud capacitance | note 1 | – | 0.8 | – | pF |
| f _T | transition frequency | I _C = 500 mA; V _{CE} = 15 V; f = 500 MHz | – | 4.0 | – | GHz |
| G _{UM} | maximum unilateral power gain (note 2) | I _C = 500 mA; V _{CE} = 15 V; f = 800 MHz; T _{amb} = 25 °C | – | 12.5 | – | dB |
| V _o | output voltage (see Fig.2) | note 3 | – | 2.5 | – | V |

Notes

- Measured with emitter and base grounded.
- G_{UM} is the maximum unilateral power gain, assuming S₁₂ is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

- d_{im} = –60 dB; I_C = 500 mA; V_{CE} = 15 V; R_L = 75 Ω; T_{amb} = 25 °C;
V_p = V_o at d_{im} = –60 dB; f_p = 795.25 MHz;
V_q = V_o –6 dB; f_q = 803.25 MHz;
V_r = V_o –6 dB; f_r = 805.25 MHz;
measured at f_(p+q-r) = 793.25 MHz.

NPN 4 GHz wideband transistor

BFQ136

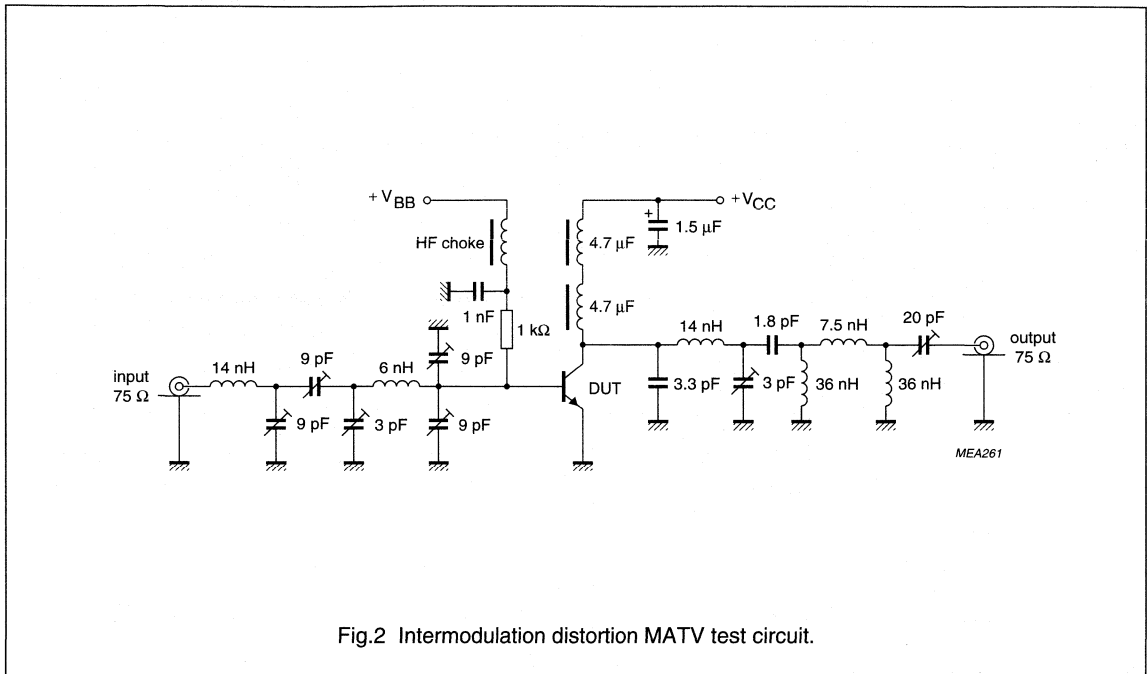


Fig.2 Intermodulation distortion MATV test circuit.

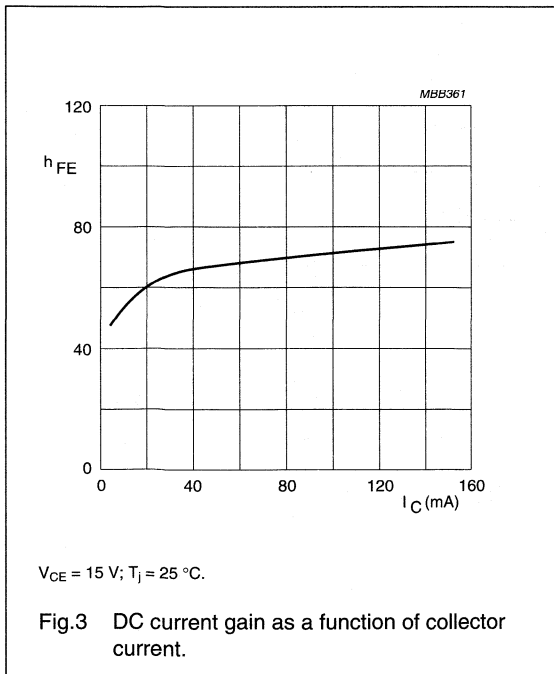


Fig.3 DC current gain as a function of collector current.

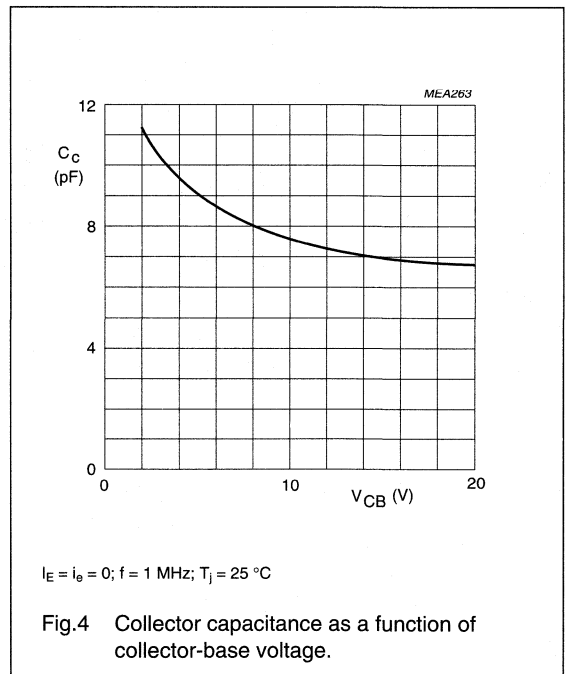
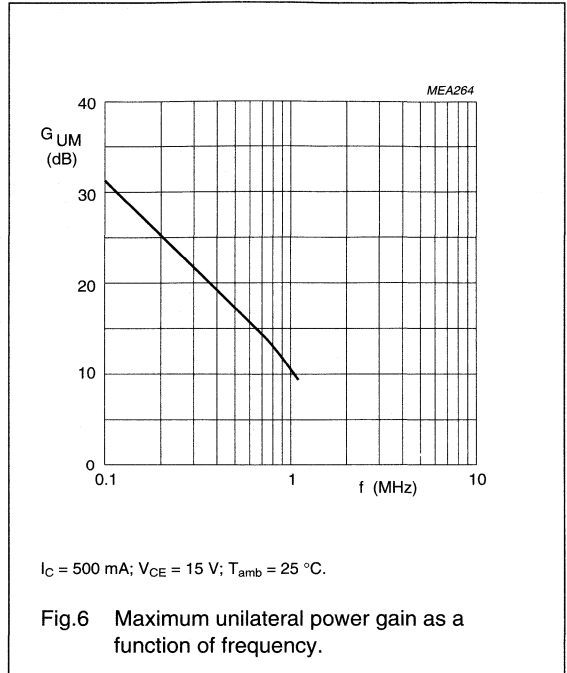
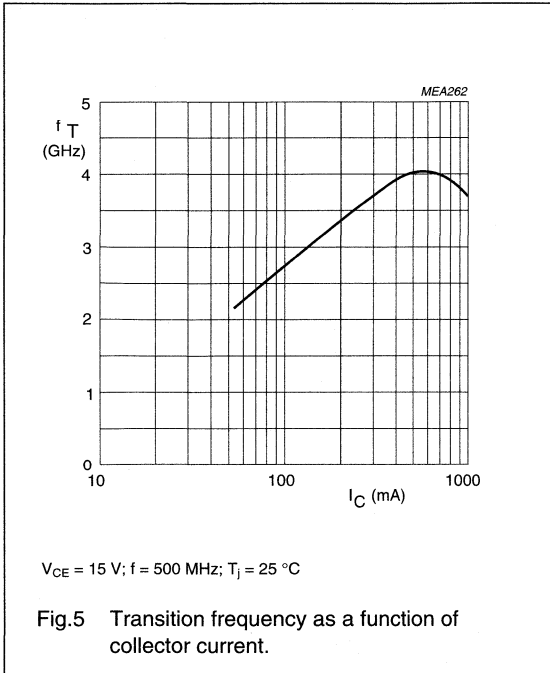


Fig.4 Collector capacitance as a function of collector-base voltage.

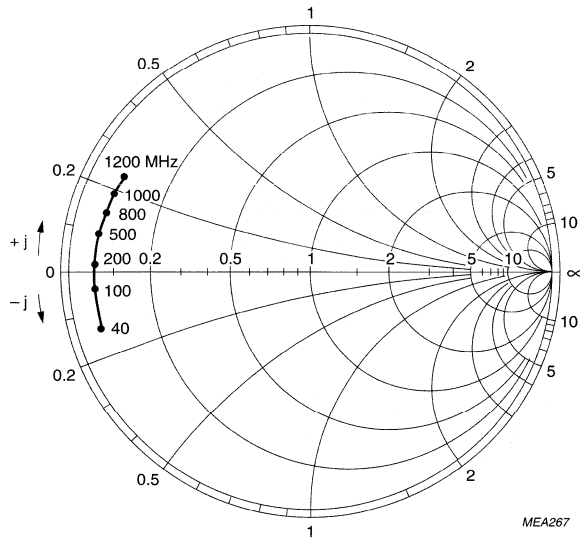
NPN 4 GHz wideband transistor

BFQ136



NPN 4 GHz wideband transistor

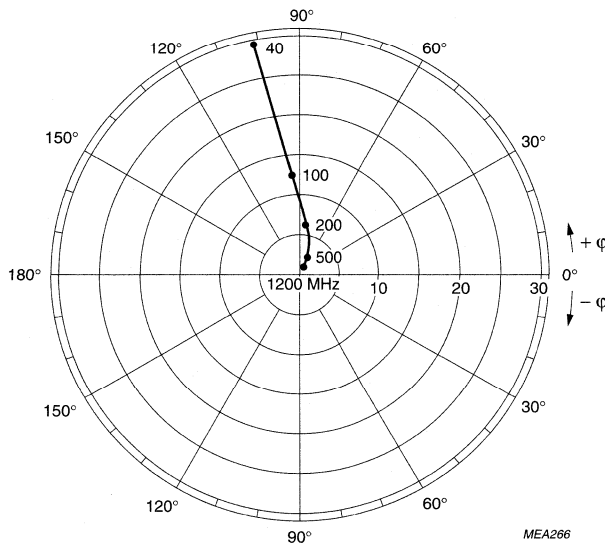
BFQ136



$I_C = 500 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_o = 50 \text{ } \Omega$.

MEA267

Fig.7 Common emitter input reflection coefficient (S_{11}).



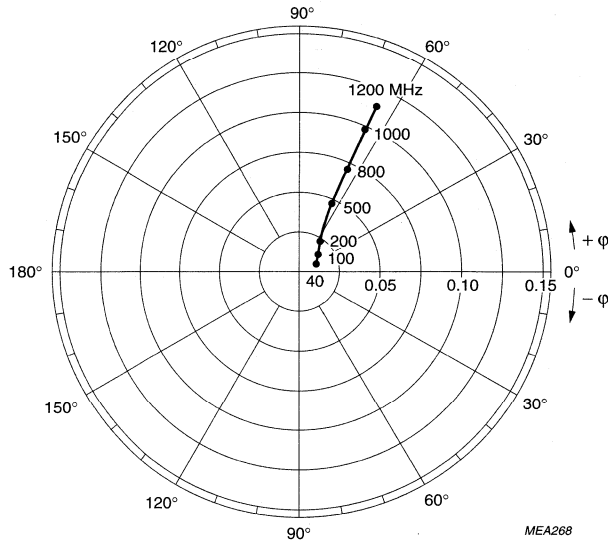
$I_C = 500 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

MEA266

Fig.8 Common emitter forward transmission coefficient (S_{21}).

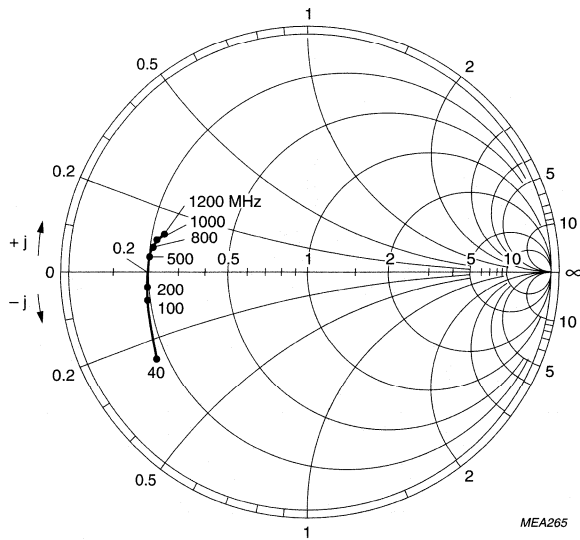
NPN 4 GHz wideband transistor

BFQ136



$I_C = 500 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.9 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 500 \text{ mA}$; $V_{CE} = 15 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_0 = 50 \text{ } \Omega$.

Fig.10 Common emitter output reflection coefficient (S_{22}).

PNP 5 GHz wideband transistor

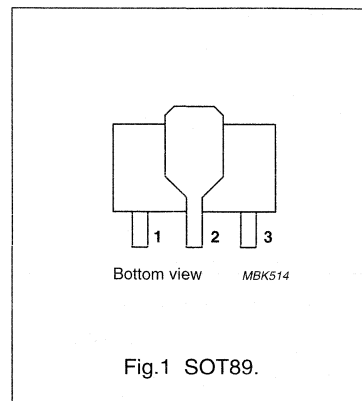
BFQ149

DESCRIPTION

PNP transistor in a SOT89 envelope. It is intended for use in UHF applications such as broadband aerial amplifiers (30 to 860 MHz) and in microwave amplifiers such as radar systems, spectrum analyzers, etc., using SMD technology.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: FG | |
| 1 | emitter |
| 2 | collector |
| 3 | base |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | – | – | –15 | V |
| I_C | DC collector current | | – | – | –100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ °C}$ (note 1) | – | – | 1 | W |
| h_{FE} | DC current gain | $I_C = -70\text{ mA}$; $V_{CE} = -10\text{ V}$; $T_j = 25\text{ °C}$ | 20 | 50 | – | |
| f_T | transition frequency | $I_C = -75\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ °C}$ | 4 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = -50\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 12 | – | dB |
| F | noise figure | $I_C = -50\text{ mA}$; $V_{CE} = -10\text{ V}$; $R_s = 60\text{ }\Omega$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 3.75 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | –20 | V |
| V_{CE0} | collector-emitter voltage | open base | – | –15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | –3 | V |
| I_C | DC collector current | | – | –100 | mA |
| I_{CM} | peak collector current | $f > 1\text{ MHz}$ | – | –150 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ °C}$ (note 1) | – | 1 | W |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 150 | °C |

Note

- T_s is the temperature at the soldering point of the collector tab.

PNP 5 GHz wideband transistor

BFQ149

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 135\text{ °C}$ (note 1) | 40 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = -10\text{ V};$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = -70\text{ mA}; V_{CE} = -10\text{ V}$ | 20 | 50 | – | |
| f_T | transition frequency | $I_C = -70\text{ mA}; V_{CE} = -10\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | 4 | 5 | – | GHz |
| C_c | collector capacitance | $I_E = 0; V_{CB} = -10\text{ V}; f = 1\text{ MHz}$ | – | 2 | – | pF |
| C_e | emitter capacitance | $I_C = 0; V_{EB} = -0.5\text{ V}; f = 1\text{ MHz}$ | – | 4 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = -10\text{ V}; f = 1\text{ MHz}$ | – | 1.7 | – | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = -50\text{ mA}; V_{CE} = -10\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 12 | – | dB |
| F | noise figure | $I_C = -50\text{ mA}; V_{CE} = -10\text{ V};$ $R_s = 60\text{ }\Omega; f = 500\text{ MHz};$ $T_{amb} = 25\text{ °C}$ | – | 3.75 | – | dB |

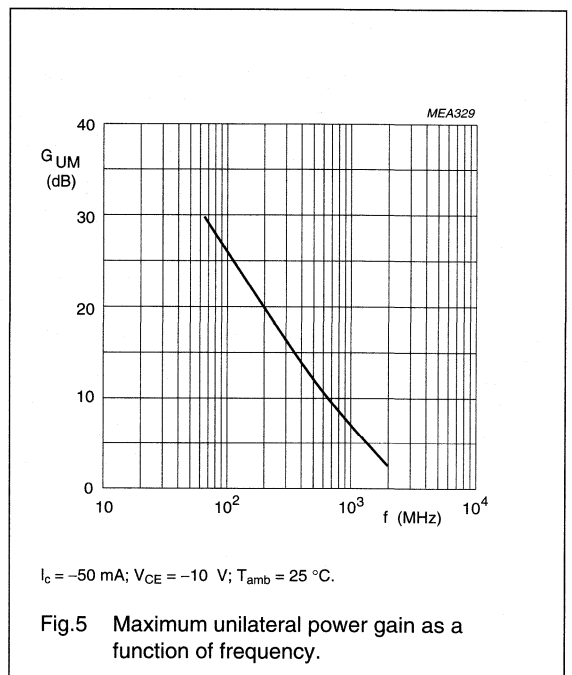
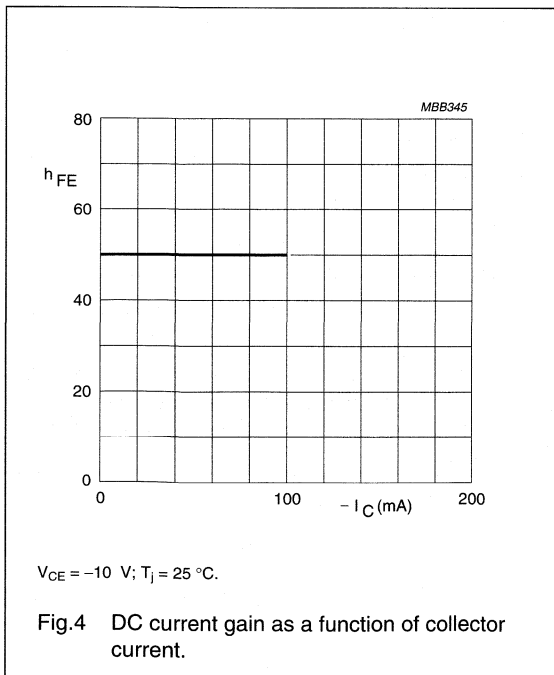
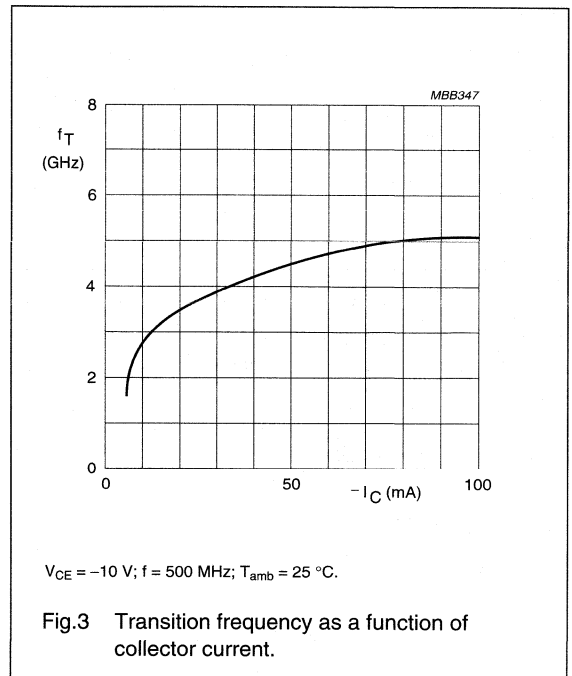
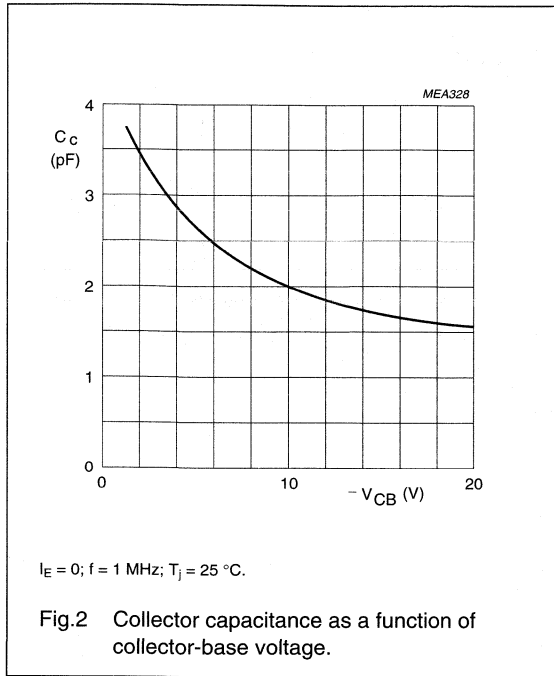
Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{dB.}$$

PNP 5 GHz wideband transistor

BFQ149



NPN 6 GHz wideband transistor

BFQ270

FEATURES

- High power gain
- Emitter-ballasting resistors for good thermal stability
- Gold metallization ensures excellent reliability.

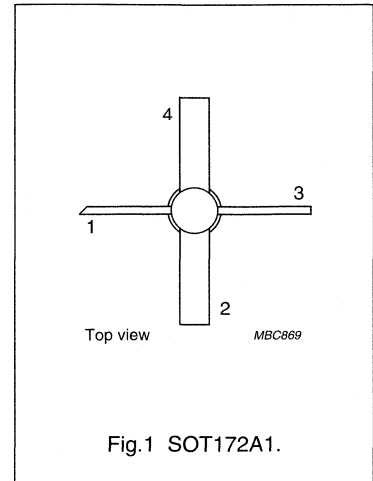
DESCRIPTION

Silicon NPN transistor mounted in a 4-lead dual-emitter SOT172A1 envelope with a ceramic cap. All leads are isolated from the mounting base.

It is primarily intended for use in MATV and CATV amplifiers.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | — | — | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | — | — | 19 | V |
| I_C | DC collector current | | — | — | 500 | mA |
| P_{tot} | total power dissipation | up to $T_c = 100\text{ }^\circ\text{C}$ | — | — | 10 | W |
| h_{FE} | DC current gain | $I_C = 240\text{ mA}$; $V_{CE} = 18\text{ V}$; $T_j = 25\text{ }^\circ\text{C}$ | 60 | — | — | |
| f_T | transition frequency | $I_C = 240\text{ mA}$; $V_{CE} = 18\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | — | 6 | — | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 240\text{ mA}$; $V_{CE} = 18\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | — | 10 | — | dB |
| V_O | output voltage | $d_{im} = -60\text{ dB}$; $I_C = 240\text{ mA}$; $V_{CE} = 18\text{ V}$; $R_L = 75\text{ }\Omega$; $f_{(p+q-r)} = 793.25\text{ MHz}$ | — | 1.6 | — | V |

WARNING

Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO discs are not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

NPN 6 GHz wideband transistor

BFQ270

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|---------------------------|-------------------------------|------|------|------|
| V _{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V _{CEO} | collector-emitter voltage | open base | – | 19 | V |
| V _{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I _C | DC collector current | | – | 500 | mA |
| P _{tot} | total power dissipation | up to T _c = 100 °C | – | 10 | W |
| T _{stg} | storage temperature | | –65 | 150 | °C |
| T _j | junction temperature | | – | 200 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------------|--|--------------------|
| R _{th j-c} | thermal resistance from junction to case | 10 K/W |

CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

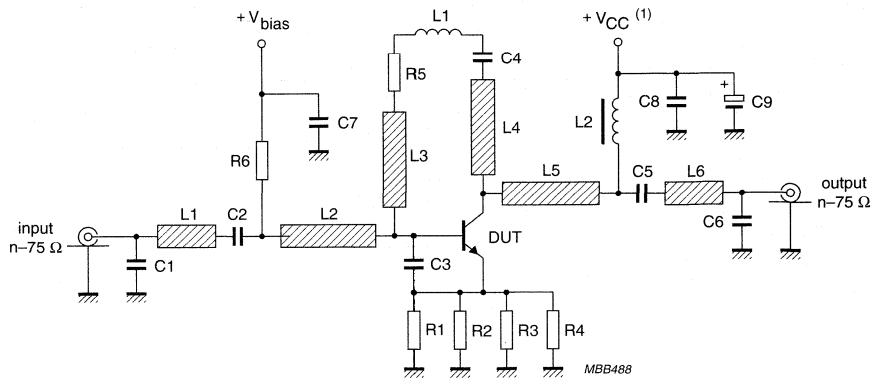
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------|--|---|------|------|------|------|
| I _{CBO} | collector cut-off current | I _E = 0; V _{CB} = 18 V | – | – | 100 | μA |
| h _{FE} | DC current gain | I _C = 240 mA; V _{CE} = 18 V | 60 | 110 | – | |
| C _c | collector capacitance | I _E = I _e = 0; V _{CB} = 18 V; f = 1 MHz | – | 3.6 | – | pF |
| C _e | emitter capacitance | I _C = I _c = 0; V _{EB} = 0.5 V; f = 1 MHz | – | 11 | – | pF |
| C _{re} | feedback capacitance | I _C = 0; V _{CB} = 18 V; f = 1 MHz | 2 | 2.6 | – | pF |
| C _{cs} | collector-stud capacitance | | – | 1.2 | – | pF |
| f _T | transition frequency | I _C = 240 mA; V _{CE} = 18 V; f = 1 GHz; T _{amb} = 25 °C | 4.5 | 6 | – | GHz |
| G _{UM} | maximum unilateral power gain (note 1) | I _C = 240 mA; V _{CE} = 18 V; f = 500 MHz; T _{amb} = 25 °C | – | 16 | – | dB |
| | | I _C = 240 mA; V _{CE} = 18 V; f = 1 GHz; T _{amb} = 25 °C | – | 10 | – | dB |
| V _O | output voltage | note 2 | – | 1.6 | – | V |
| d ₂ | second order intermodulation distortion | note 3 | – | –50 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S₁₂ is zero and $G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right)$ dB
- d_{im} = –60 dB (DIN 45004); I_C = 240 mA; V_{CE} = 18 V; R_L = 75 Ω;
V_p = V_O; f_p = 795.25 MHz;
V_q = V_O – 6 dB; f_q = 803.25 MHz;
V_r = V_O – 6 dB; f_r = 805.25 MHz;
measured at f_(p+q-r) = 793.25 MHz.
- I_C = 240 mA; V_{CE} = 18 V; R_L = 75 Ω;
V_p = V_q = V_O = 50.5 dBmV = 335 mV;
f_(p+q) = 810 MHz; f_p = 250 MHz; f_q = 560 MHz.

NPN 6 GHz wideband transistor

BFQ270



(1) $+V_{CC}$ is equivalent to $V_{CE} = V_c - I_c (A) \times 17$.

Fig.2 Intermodulation and second order intermodulation distortion test circuit.

List of components (see test circuit)

| DESIGNATION | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE NO. |
|----------------|--|-----------------|-----------------------------|----------------|
| C1 | miniature ceramic plate capacitor | 0.82 pF | | 2222 680 03827 |
| C2, C5, C7, C8 | multilayer ceramic capacitor | 10 nF | | 2222 852 47103 |
| C3 | multilayer ceramic chip capacitor | 2.2 pF | | 2222 855 12228 |
| C4 (note 1) | miniature ceramic plate capacitor | 1 nF | | 2222 630 08102 |
| C6 | miniature ceramic plate capacitor | 1.2 pF | | 2222 680 03128 |
| C9 | electrolytic capacitor | 4.7 μ F | | 2222 014 28478 |
| L1 (note 1) | 4.5 turns loosely wound 0.4 mm enamelled copper wire | \approx 35 nH | internal coil diameter 2 mm | |
| L2 | Ferroxcube choke | 5 μ H | | 3122 108 20153 |
| ML1, ML6 | microstripline | 75 Ω | width 2.46 mm; length 9 mm | |
| ML2, ML5 | microstripline | 75 Ω | width 2.46 mm; length 22 mm | |
| ML3, ML4 | microstripline | 145 Ω | width 0.5 mm; length 12 mm | |
| R1, R2, R3, R4 | metal film resistor | 68 Ω | type MR25 | 2322 151 76819 |
| R5 (note 1) | metal film resistor | 240 Ω | type SFR16T | 2322 180 73241 |
| R6 | metal film resistor | 10 k Ω | type SFR16T | 2322 180 73103 |

Note

- Components C4, L1, and R5 are mounted in a cavity in the brass ground plate.

The circuit is constructed on a printed circuit board and 10 mm thick brass ground plate, with a relative dielectric constant of ($\epsilon_r = 2.2$), thickness 1.57 mm; thickness of copper 0.017 mm (E.G. Rogers' RT/Duroid 5880).

NPN 6 GHz wideband transistor

BFQ270

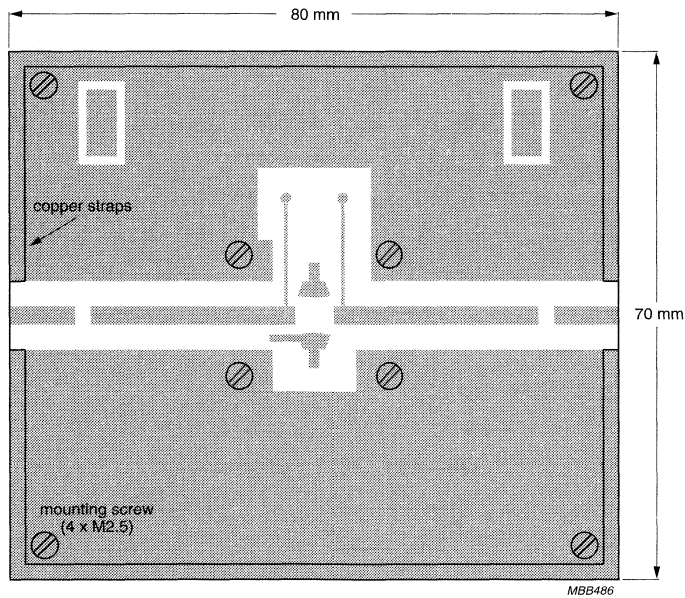
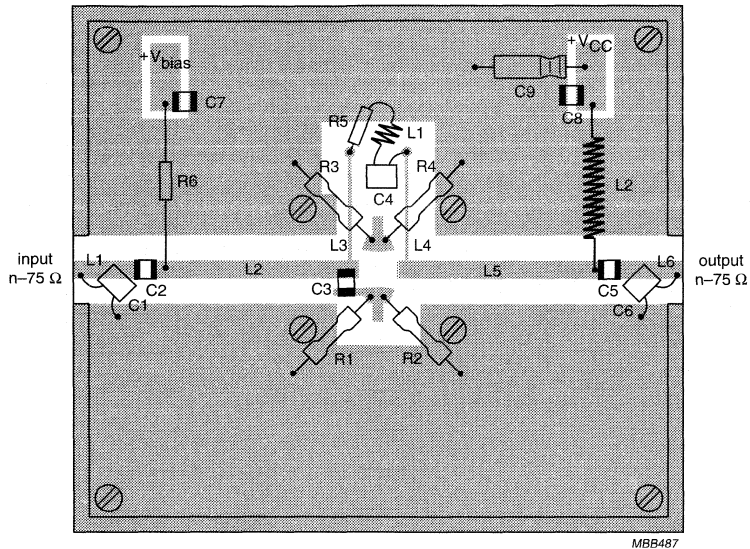
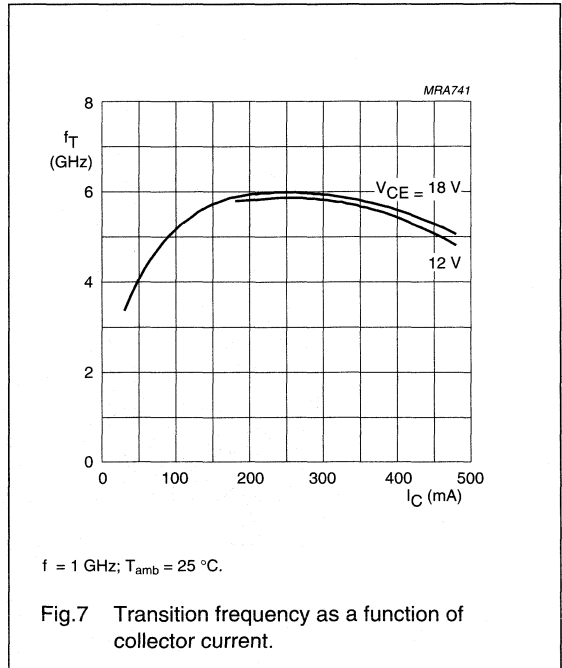
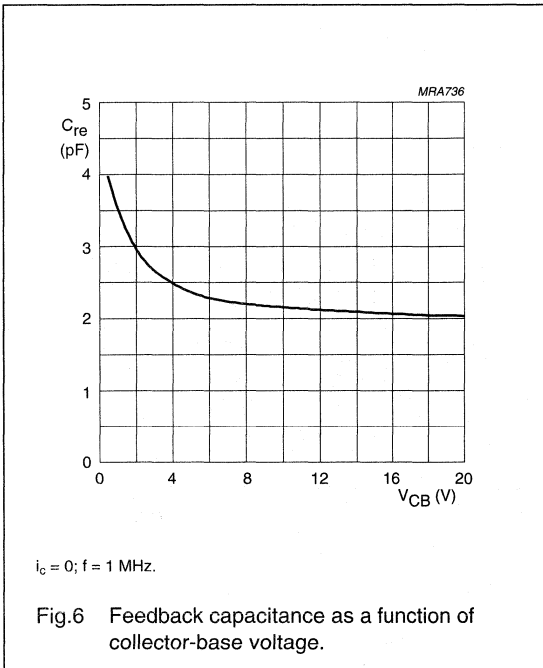
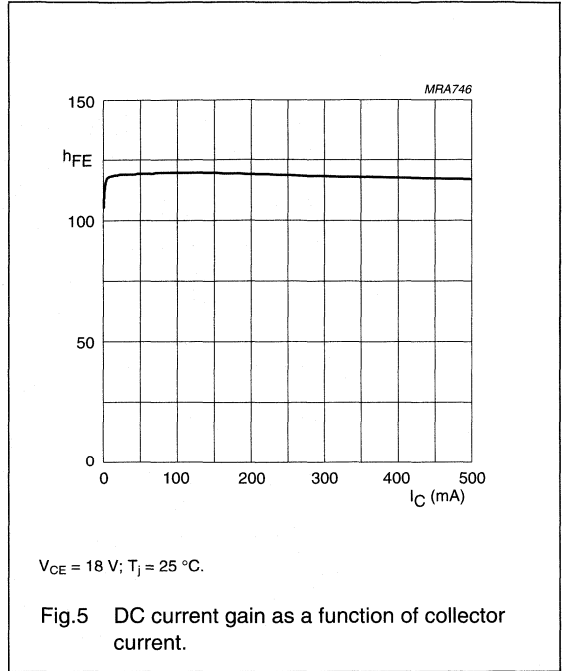
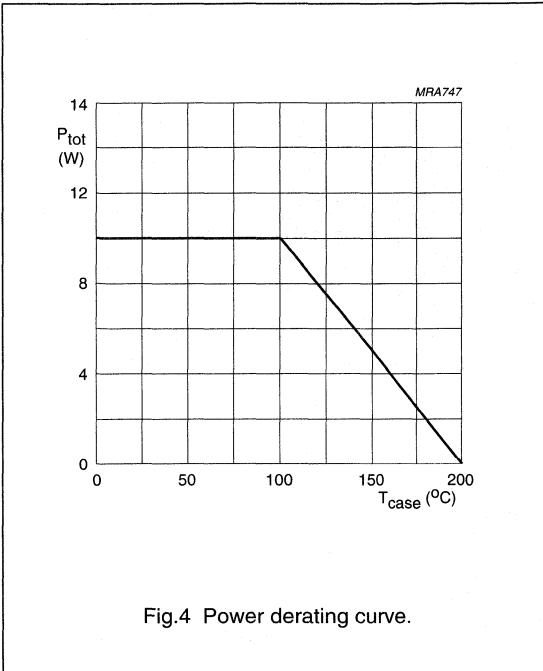


Fig.3 Intermodulation test circuit printed circuit board.

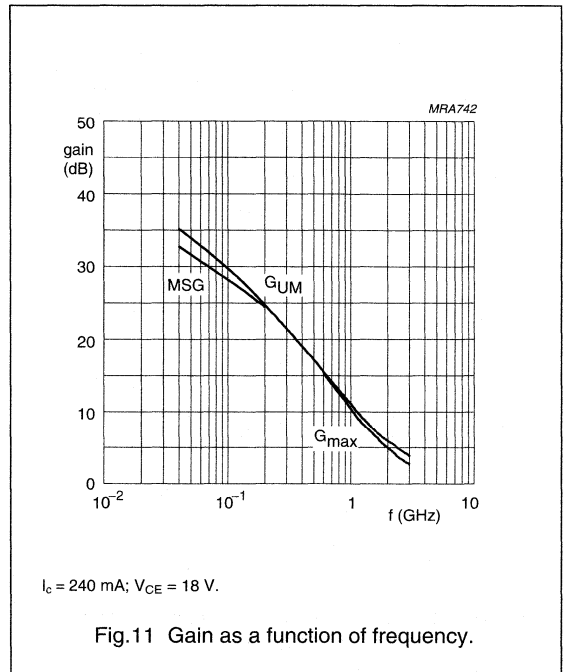
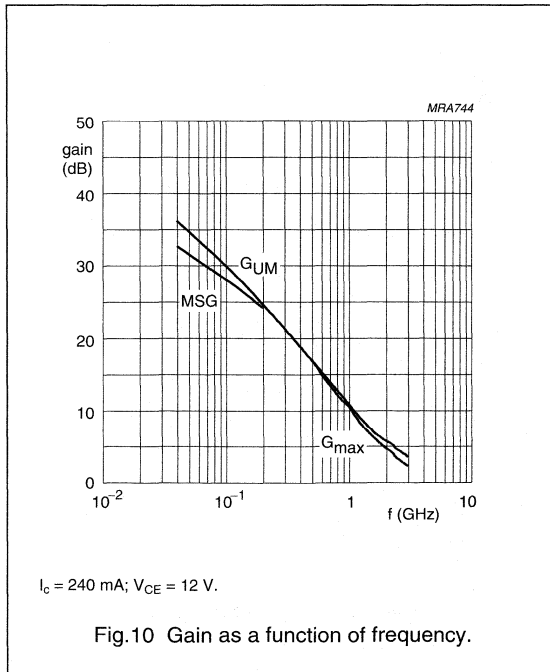
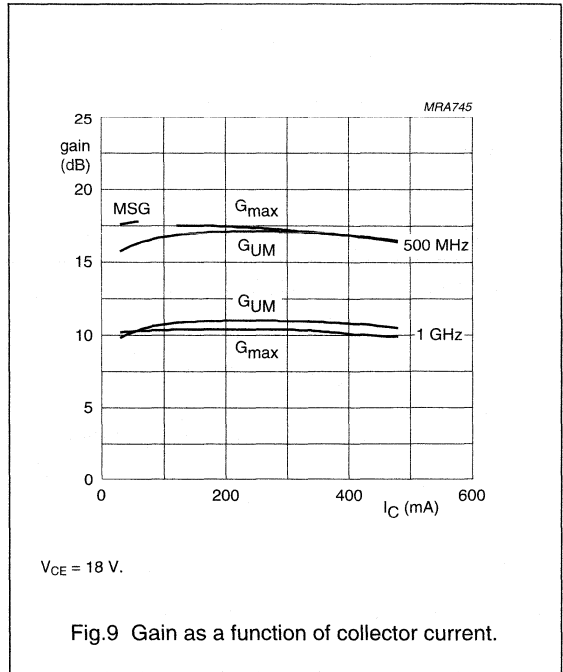
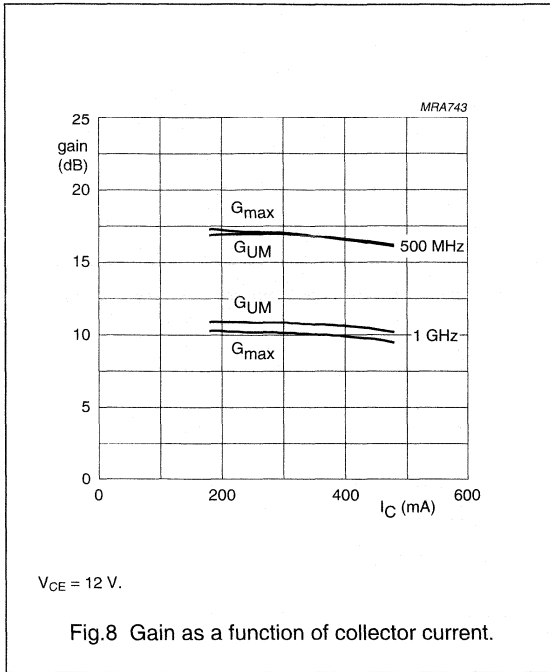
NPN 6 GHz wideband transistor

BFQ270



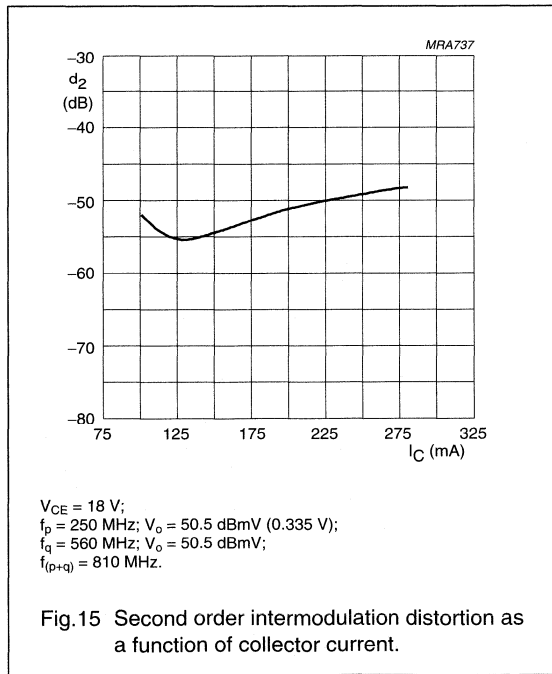
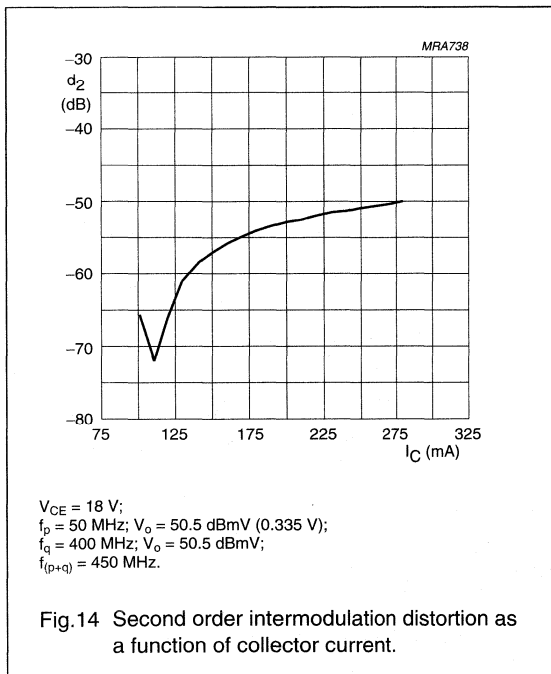
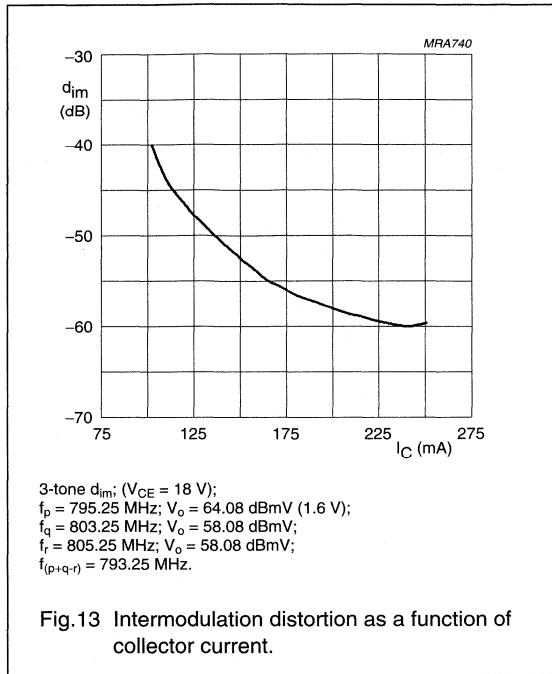
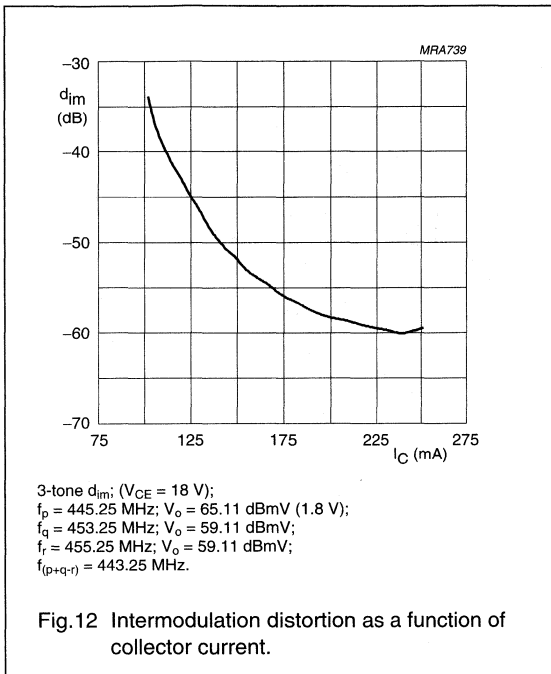
NPN 6 GHz wideband transistor

BFQ270



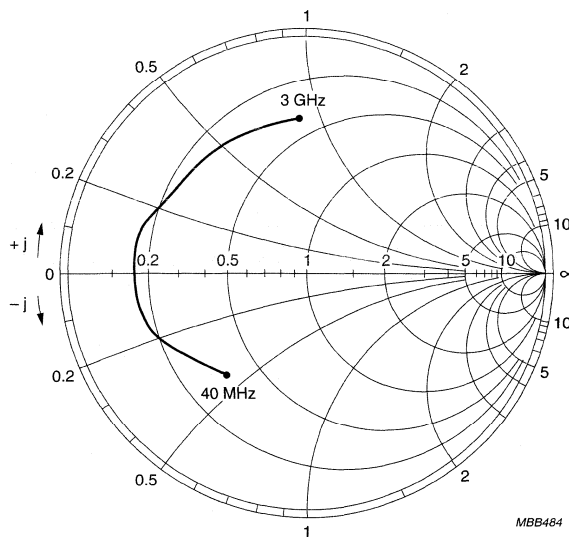
NPN 6 GHz wideband transistor

BFQ270



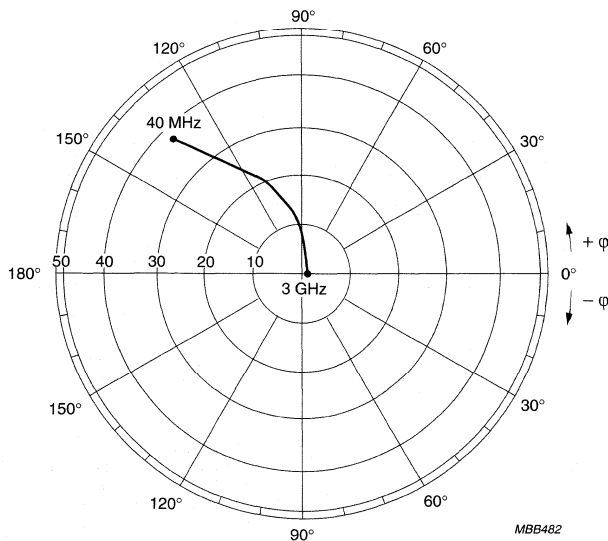
NPN 6 GHz wideband transistor

BFQ270



$I_c = 240 \text{ mA}$; $V_{CE} = 18 \text{ V}$.
 $Z_o = 50 \Omega$.

Fig.16 Common emitter input reflection coefficient (S_{11}).

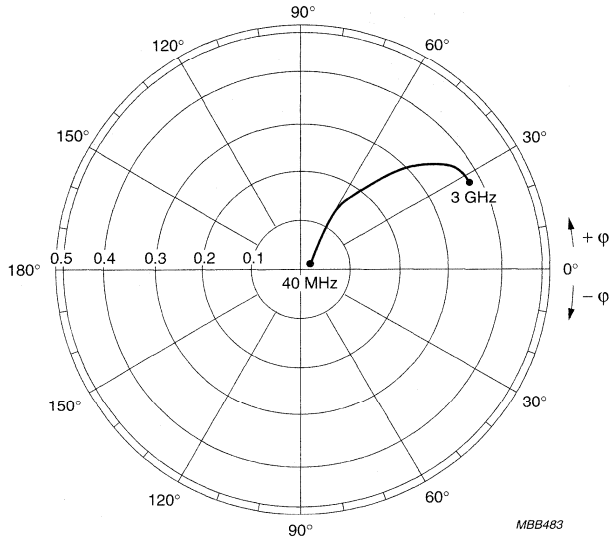


$I_c = 240 \text{ mA}$; $V_{CE} = 18 \text{ V}$.

Fig.17 Common emitter forward transmission coefficient (S_{21}).

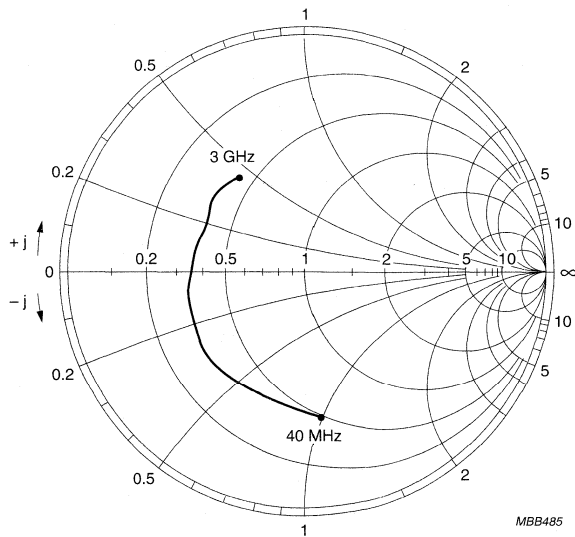
NPN 6 GHz wideband transistor

BFQ270



$I_c = 240 \text{ mA}; V_{CE} = 18 \text{ V}.$

Fig.18 Common emitter reverse transmission coefficient (S_{12}).



$I_c = 240 \text{ mA}; V_{CE} = 18 \text{ V}.$
 $Z_0 = 50 \Omega.$

Fig.19 Common emitter output reflection coefficient (S_{22}).

NPN 9 GHz wideband transistor

BFQ540

FEATURES

- High gain
- High output voltage
- Low noise
- Gold metallization ensures excellent reliability
- Low thermal resistance.

APPLICATIONS

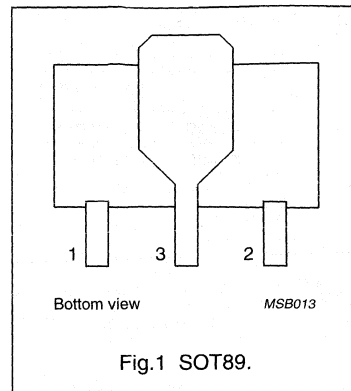
- VHF, UHF and CATV amplifiers.

DESCRIPTION

Silicon NPN transistor in a plastic SOT89 package.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | emitter |
| 2 | base |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|---------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | – | 2 | V |
| I_C | DC collector current | | – | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 60$ °C; note 1 | – | – | 1.2 | W |
| h_{FE} | DC current gain | $I_C = 40$ mA; $V_{CE} = 8$ V; $T_j = 25$ °C | 60 | 120 | 250 | |
| f_T | transition frequency | $I_C = 40$ mA; $V_{CE} = 8$ V; $f = 1$ GHz; $T_{amb} = 25$ °C | – | 9 | – | GHz |
| $ S_{21} ^2$ | insertion power gain | $I_C = 40$ mA; $V_{CE} = 8$ V; $f = 900$ MHz; $T_{amb} = 25$ °C | 12 | 13 | – | dB |
| F | noise figure | $I_C = 40$ mA; $V_{CE} = 8$ V; $f = 900$ MHz; $\Gamma_S = \Gamma_{opt}$ | – | 1.9 | 2.4 | dB |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 9 GHz wideband transistor

BFQ540

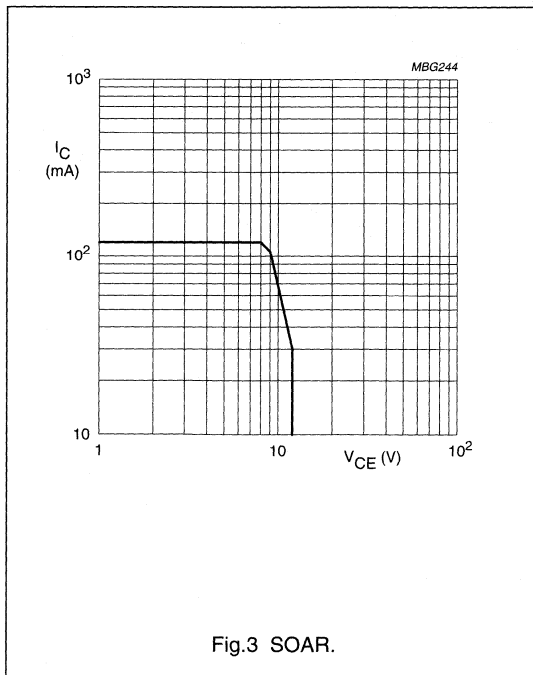
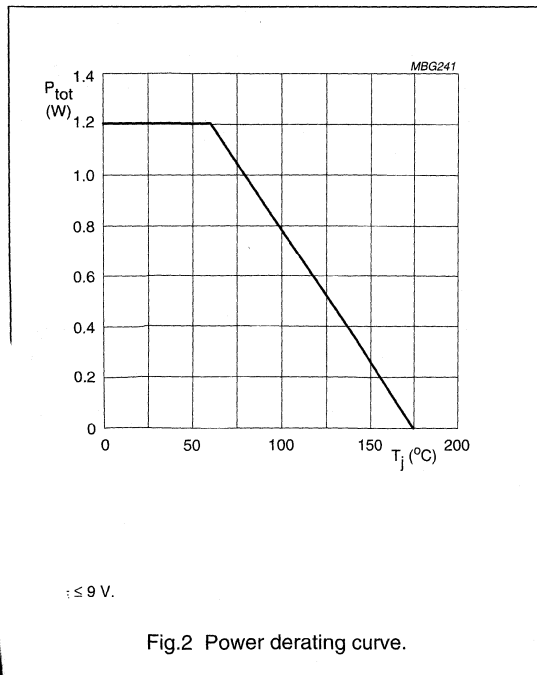
LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | - | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | - | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | - | 2 | V |
| I_C | DC collector current | | - | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 60\text{ }^\circ\text{C}$ | - | 1.2 | W |
| T_{stg} | storage temperature | | -65 | +150 | $^\circ\text{C}$ |
| T_j | operating junction temperature | | - | 175 | $^\circ\text{C}$ |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 60\text{ }^\circ\text{C}$; $P_{tot} = 1.2\text{ W}$ | 95 | K/W |



NPN 9 GHz wideband transistor

BFQ540

CHARACTERISTICS

$T_j = 25\text{ °C}$ (unless otherwise specified).

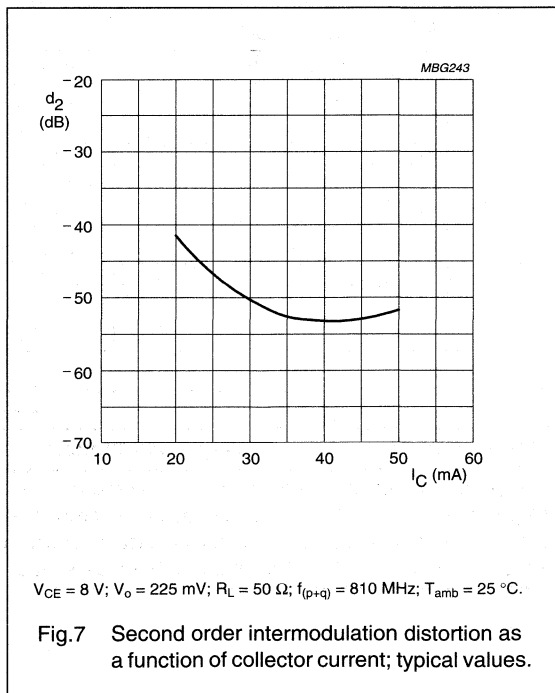
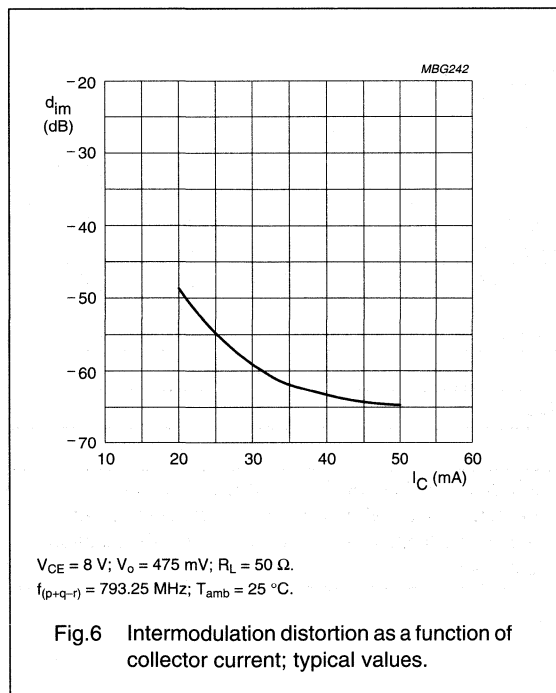
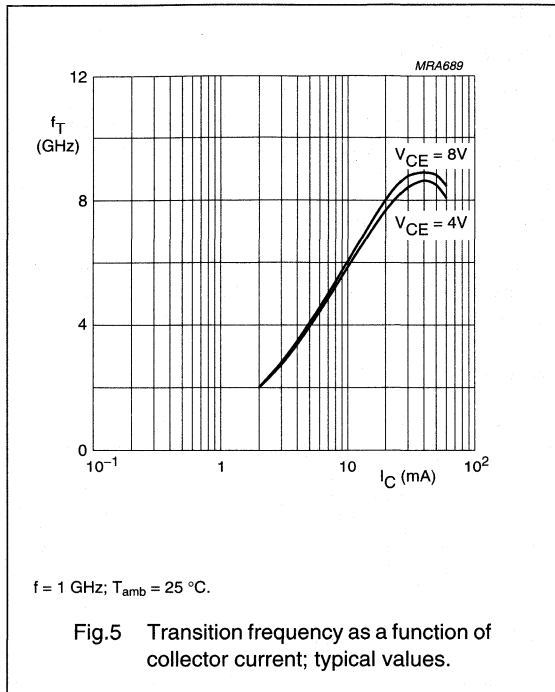
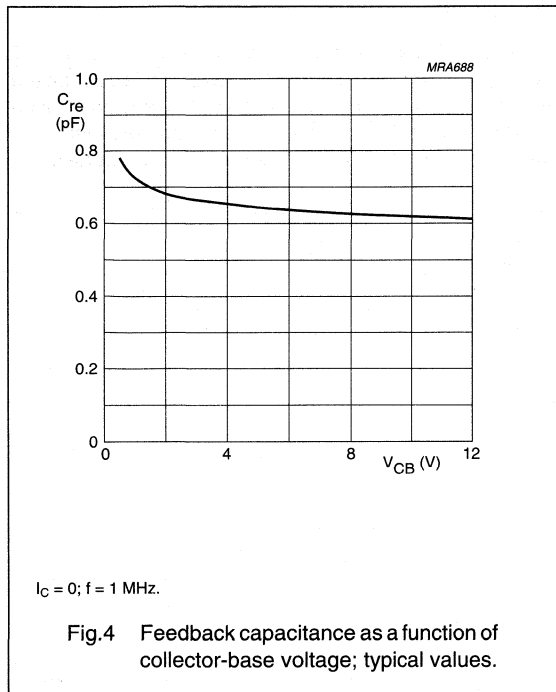
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|---|--|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 10\text{ }\mu\text{A}$; $I_E = 0$ | 20 | – | – | V |
| $V_{(BR)CES}$ | collector-emitter breakdown voltage | $R_{BE} = 0$; $I_C = 40\text{ }\mu\text{A}$ | 15 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 100\text{ }\mu\text{A}$; $I_C = 0$ | 2 | – | – | V |
| I_{CBO} | collector-base leakage current | $V_{CB} = 8\text{ V}$; $I_E = 0$ | – | – | 50 | nA |
| I_{EBO} | emitter-base leakage current | $V_{CB} = 1\text{ V}$; $I_C = 0$ | – | – | 200 | nA |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$ | 60 | 120 | 250 | |
| f_T | transition frequency | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f_m = 1\text{ GHz}$ | – | 9 | – | GHz |
| C_e | emitter capacitance | $I_C = i_e = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 2 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.9 | – | pF |
| $ S_{21} ^2$ | insertion power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 12 | 13 | – | dB |
| V_o | output voltage | note 1 | – | 500 | – | mV |
| | | note 2 | – | 350 | – | mV |
| d_2 | second order intermodulation distortion | note 3 | – | – | –53 | dB |
| F | noise figure | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $\Gamma_S = \Gamma_{opt}$ | – | 1.9 | 2.4 | dB |

Notes

- $d_{im} = -60\text{ dB}$ (DIN45004B); $V_{CE} = 8\text{ V}$; $I_C = 40\text{ mA}$; $R_L = 50\text{ }\Omega$;
 $V_p = V_o$; $V_q = V_o - 6\text{ dB}$; $V_r = V_o - 6\text{ dB}$;
 $f_p = 795.25\text{ MHz}$; $f_q = 803.25\text{ MHz}$; $f_r = 805.5\text{ MHz}$;
measured at $f_{(p+q-r)} = 793.25\text{ MHz}$.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$;
 $V_p = V_q = V_o$; $f_p = 806\text{ MHz}$; $f_q = 810\text{ MHz}$;
measured at $f_{(2p-q)} = 802\text{ MHz}$.
- $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$;
 $V_p = V_q = 225\text{ mV}$; $f_p = 250\text{ MHz}$; $f_q = 560\text{ MHz}$;
measured at $f_{(p+q)} = 810\text{ MHz}$.

NPN 9 GHz wideband transistor

BFQ540



NPN 7 GHz wideband transistor

BFQ621

FEATURES

- High power gain
- High output voltage
- High maximum junction temperature
- Gold metallization ensures excellent reliability.

APPLICATIONS

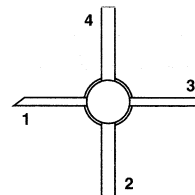
It is primarily intended for use in MATV and microwave amplifiers, such as aerial amplifiers, radar systems, oscilloscopes, spectrum analyzers, etc.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |

DESCRIPTION

Silicon NPN transistor in a 4-lead dual-emitter SOT172A2 package with a ceramic cap. All leads are isolated from the mounting base. Emitter ballasting resistors and application of gold sandwich metallization ensures an optimum temperature profile and excellent reliability properties.



Top view

MSA467

Fig.1 SOT172A2.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CE0} | collector-emitter voltage | open base | – | – | 16 | V |
| I_C | collector current (DC) | | – | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_{mb} = 25\text{ °C}$ | – | – | 8 | W |
| h_{FE} | DC current gain | $I_C = 120\text{ mA}$; $V_{CE} = 18\text{ V}$; $T_{amb} = 25\text{ °C}$ | 40 | – | – | |
| f_T | transition frequency | $I_C = 120\text{ mA}$; $V_{CE} = 18\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 7 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 120\text{ mA}$; $V_{CE} = 18\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 18.5 | – | dB |
| V_O | output voltage | $I_C = 120\text{ mA}$; $V_{CE} = 18\text{ V}$; $f_{(p+q-r)} = 793.25\text{ MHz}$; $d_{im} = -60\text{ dB}$; $R_L = 75\text{ }\Omega$ | – | 1.2 | – | V |

WARNING

Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

NPN 7 GHz wideband transistor

BFQ621

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 16 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | collector current (DC) | | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_{mb} = 25\text{ °C}$ | – | 8 | W |
| T_{stg} | storage temperature | | –65 | +175 | °C |
| T_j | junction temperature | | – | +200 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|----------------|---|--|-------|------|
| $R_{th\ j-mb}$ | thermal resistance from junction to mounting base | $P_{tot} = 8\text{ W}$; up to $T_{mb} = 25\text{ °C}$ | 21.9 | K/W |

NPN 7 GHz wideband transistor

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CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ (unless otherwise specified).

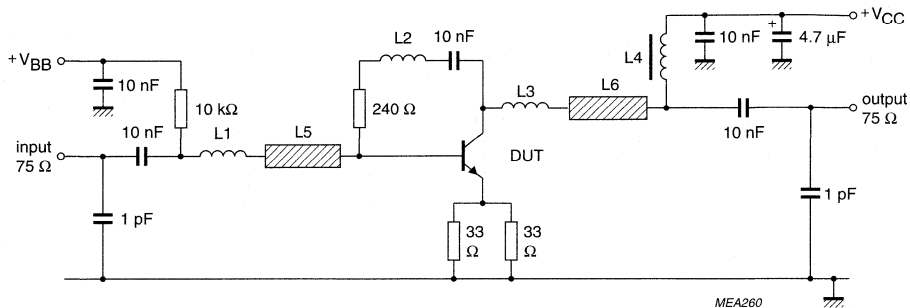
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|--|---|------|------|------|---------------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | $I_C = 0.1\text{ mA}; I_E = 0$ | – | – | 25 | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | $I_C = 10\text{ mA}; I_B = 0$ | – | – | 16 | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | $I_E = 0.1\text{ mA}; I_C = 0$ | – | – | 2 | V |
| I_{CBO} | collector-base leakage current | $I_E = 0; V_{CB} = 18\text{ V}$ | – | – | 100 | μA |
| h_{FE} | DC current gain | $I_C = 50\text{ mA}; V_{CE} = 10\text{ V}$ | 50 | – | 160 | |
| f_T | transition frequency | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V};$ $f = 1\text{ GHz};$ see Fig.3 | – | 7 | – | GHz |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 18\text{ V};$ $f = 1\text{ MHz}$ | – | 1.5 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = 0.5\text{ V};$ $f = 1\text{ MHz}$ | – | 5 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = 18\text{ V}; f = 1\text{ MHz};$ see Fig.4 | – | 0.85 | 1.2 | pF |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C};$ | – | 18.5 | – | dB |
| | | $I_C = 120\text{ mA}; V_{CE} = 18\text{ V};$ $f = 800\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C};$ | – | 14.5 | – | dB |
| V_O | output voltage | note 2 | – | 1.35 | – | V |
| | | note 3 | – | 1.2 | – | V |
| d_2 | second order intermodulation distortion | note 4 | – | –60 | – | dB |
| | | note 5 | – | –60 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.
- $d_{im} = -60\text{ dB}$ (DIN45004B); see Fig.2; $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ }^\circ\text{C};$
 $V_p = V_O; f_p = 445.25\text{ MHz};$
 $V_q = V_O - 6\text{ dB}; f_q = 453.25\text{ MHz};$
 $V_r = V_O - 6\text{ dB}; f_r = 455.25\text{ MHz};$
measured at $f_{(p+q-r)} = 443.25\text{ MHz};$ see Fig.5.
- $d_{im} = -60\text{ dB}$ (DIN45004B); see Fig.2; $I_C = 120\text{ mA}; V_{CE} = 18\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ }^\circ\text{C};$
 $V_p = V_O; f_p = 795.25\text{ MHz};$
 $V_q = V_O - 6\text{ dB}; f_q = 803.25\text{ MHz};$
 $V_r = V_O - 6\text{ dB}; f_r = 805.25\text{ MHz};$
measured at $f_{(p+q-r)} = 793.25\text{ MHz};$ see Fig.6.
- $V_O = 50\text{ dBmV} = 316\text{ mV}; I_C = 90\text{ mA}; V_{CE} = 18\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ }^\circ\text{C};$
measured at $f_{(p+q)} = 450\text{ MHz};$ see Fig.7.
- $V_O = 50\text{ dBmV} = 316\text{ mV}; I_C = 90\text{ mA}; V_{CE} = 18\text{ V}; R_L = 75\text{ }\Omega; T_{amb} = 25\text{ }^\circ\text{C};$
measured at $f_{(p+q)} = 810\text{ MHz};$ see Fig.8.

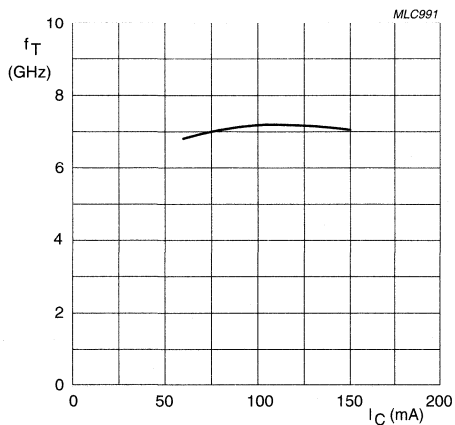
NPN 7 GHz wideband transistor

BFQ621



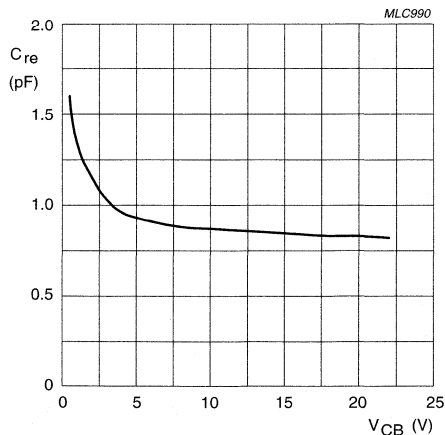
- L1 = 8 nH.
- L2 = 15 nH, 2 turns copper wire, internal diameter 2 mm.
- L3 = 10 nH, 2 turns copper wire, internal diameter 1.5 mm.
- L5: Lp = 21 mm; Rc = 75 Ω.
- L6: Lp = 16 mm; Rc = 75 Ω.

Fig.2 Intermodulation distortion and second order distortion MATV test circuit.



$V_{CE} = 18 \text{ V}; f = 1 \text{ GHz}.$

Fig.3 Transition frequency as a function of collector current; typical values.

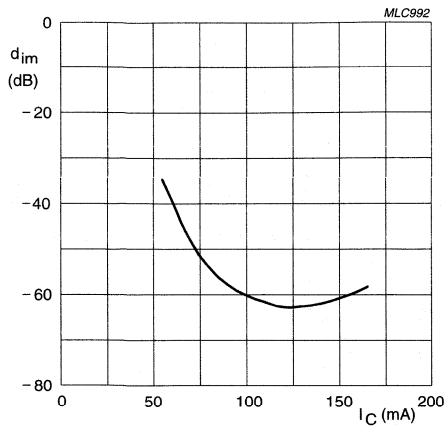


$I_C = 0; f = 1 \text{ MHz}.$

Fig.4 Feedback capacitance as a function of collector-base voltage; typical values.

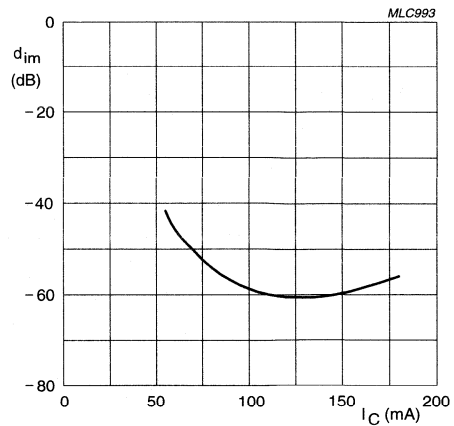
NPN 7 GHz wideband transistor

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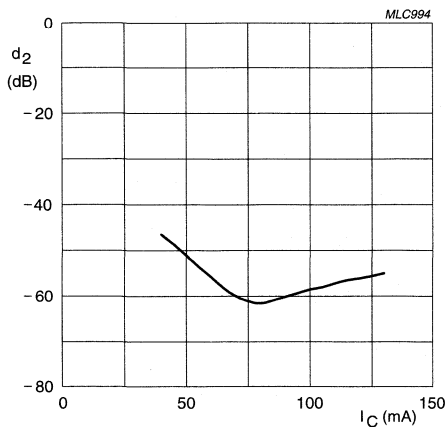
$V_O = 1.35$ V; $V_{CE} = 18$ V; $f_{(p+q-r)} = 443.25$ MHz; see Fig.2.

Fig.5 Intermodulation distortion as a function of collector current; typical values.



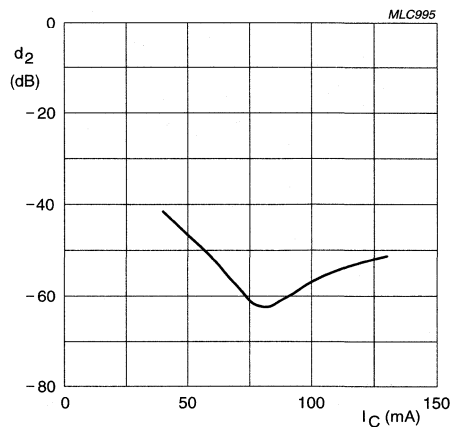
$V_O = 1.2$ V; $V_{CE} = 18$ V; $f_{(p+q-r)} = 793.25$ MHz; see Fig.2.

Fig.6 Intermodulation distortion as a function of collector current; typical values.



$V_O = 50$ dBmV = 316 mV; $V_{CE} = 18$ V; $f_{(p+q)} = 450$ MHz; see Fig.2.

Fig.7 Second order distortion as a function of collector current; typical values.

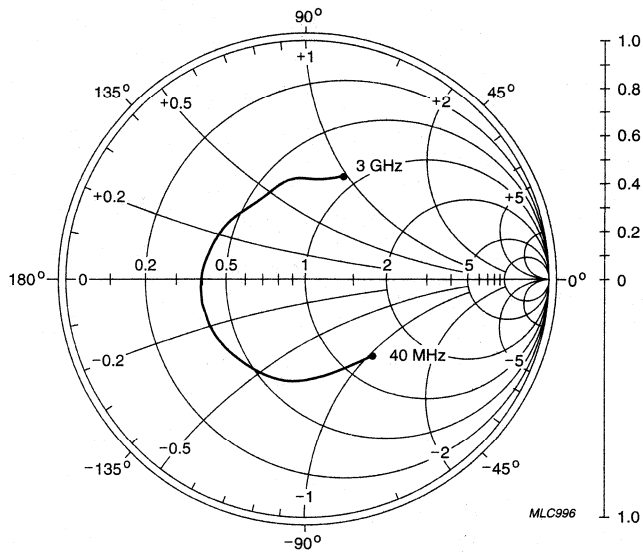


$V_O = 50$ dBmV = 316 mV; $V_{CE} = 18$ V; $f_{(p+q)} = 810$ MHz; see Fig.2.

Fig.8 Second order distortion as a function of collector current; typical values.

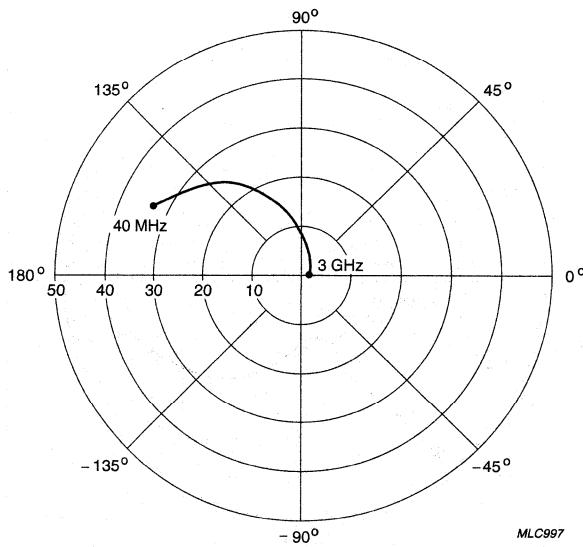
NPN 7 GHz wideband transistor

BFQ621



$V_{CE} = 18\text{ V}; I_C = 120\text{ mA}; Z_0 = 50\ \Omega.$

Fig.9 Common emitter input reflection coefficient (s_{11}); typical values.

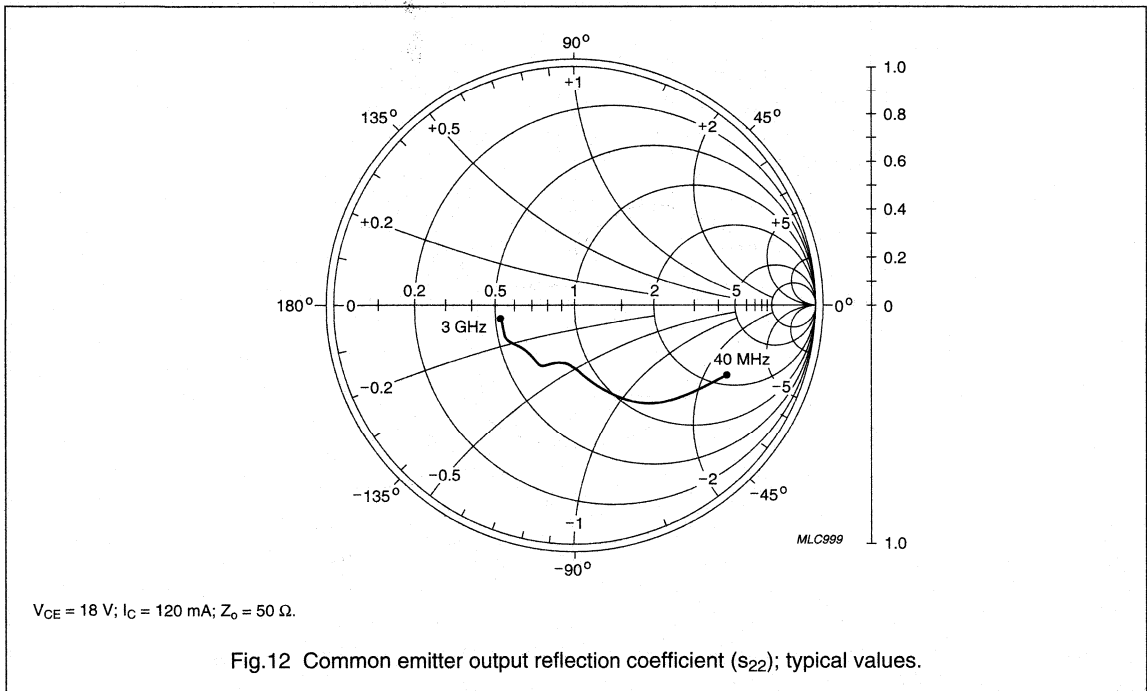
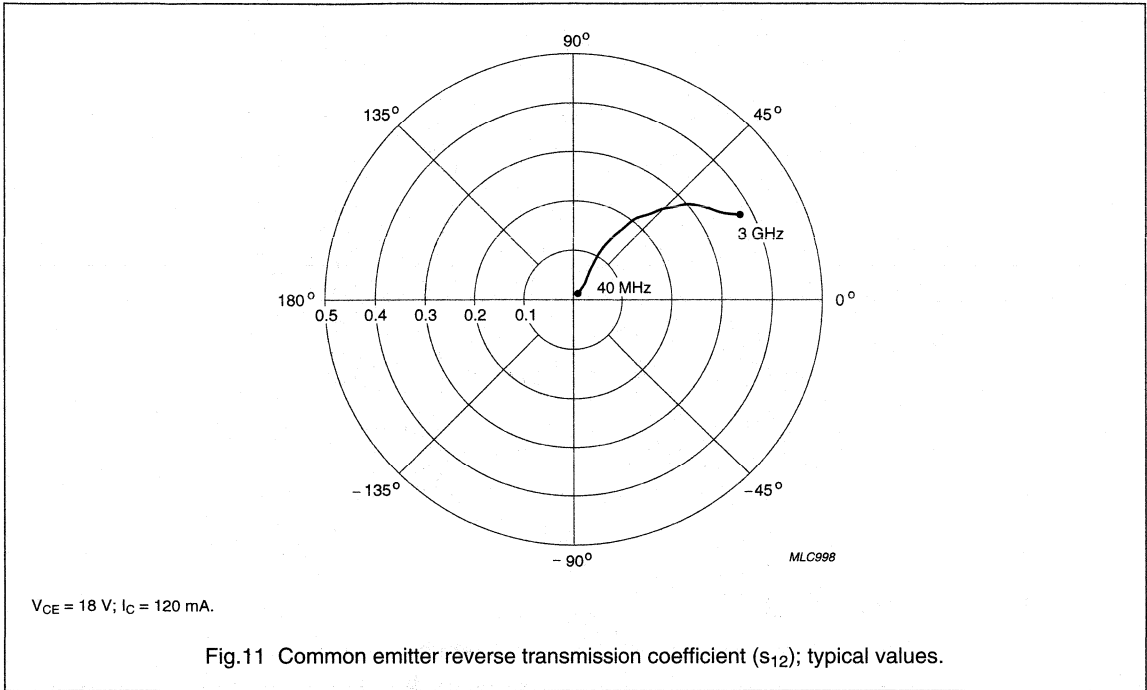


$V_{CE} = 18\text{ V}; I_C = 120\text{ mA}.$

Fig.10 Common emitter forward transmission coefficient (s_{21}); typical values.

NPN 7 GHz wideband transistor

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NPN 7 GHz wideband transistor

BFQ621

SPICE parameters for the BFQ621 crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|----------|
| 1 | IS | 1.358 | fA |
| 2 | BF | 112.2 | – |
| 3 | NF | 0.991 | – |
| 4 | VAF | 78.06 | V |
| 5 | IKF | 4.291 | A |
| 6 | ISE | 643.3 | fA |
| 7 | NE | 1.851 | – |
| 8 | BR | 5.776 | – |
| 9 | NR | 0.999 | – |
| 10 | VAR | 2.350 | V |
| 11 | IKR | 50.26 | mA |
| 12 | ISC | 2.454 | fA |
| 13 | NC | 1.175 | – |
| 14 | RB | 8.000 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 8.000 | Ω |
| 17 | RE | 1.585 | Ω |
| 18 | RC | 1.880 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 3.985 | pF |
| 23 | VJE | 0.600 | V |
| 24 | MJE | 0.327 | – |
| 25 | TF | 14.02 | ps |
| 26 | XTF | 398.1 | – |
| 27 | VTF | 2.940 | mV |
| 28 | ITF | 3.084 | A |
| 29 | PTF | 45.00 | deg |
| 30 | CJC | 1.529 | pF |
| 31 | VJC | 0.216 | V |
| 32 | MJC | 0.158 | – |
| 33 | XCJC | 0.120 | – |
| 34 | TR | 9.070 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.735 | – |

Note

- These parameters have not been extracted, the default values are shown.

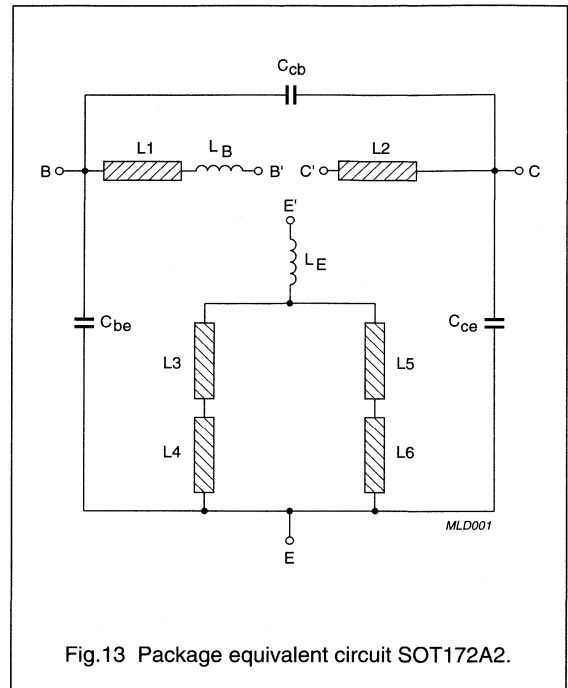


Fig.13 Package equivalent circuit SOT172A2.

List of components (see Fig.13)

| DESIGNATION | VALUE | UNIT |
|-------------|----------------------|------|
| C_{be} | 225 | fF |
| C_{cb} | 36 | fF |
| C_{ce} | 362 | fF |
| $L1^{(1)}$ | $L = 1.37; W = 2.64$ | mm |
| $L2^{(1)}$ | $L = 1.60; W = 2.64$ | mm |
| $L3^{(1)}$ | $L = 0.51; W = 0.33$ | mm |
| $L4^{(1)}$ | $L = 0.81; W = 2.06$ | mm |
| $L5^{(1)}$ | $L = 2.77; W = 0.33$ | mm |
| $L6^{(1)}$ | $L = 0.94; W = 2.06$ | mm |
| L_B | 1.85 | nH |
| L_E | 1.22 | nH |

Note

- The micro striplines are on a double copper-clad substrate; $\epsilon_r = 6.5$; $h = 1.18$ mm.

NPN 2 GHz wideband transistor

BFR53

FEATURES

- Very low intermodulation distortion
- Very high power gain.

APPLICATIONS

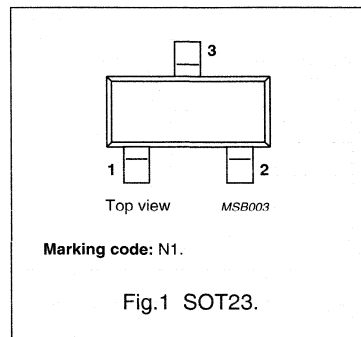
- Thick and thin-film circuits.

DESCRIPTION

NPN wideband transistor in a plastic SOT23 package.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 18 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| I_{CM} | peak collector current | $f > 1$ MHz | – | 100 | mA |
| P_{tot} | total power dissipation | $T_s \leq 85$ °C | – | 250 | mW |
| C_{re} | feedback capacitance | $I_C = 2$ mA; $V_{CE} = 5$ V; $f = 1$ MHz; $T_{amb} = 25$ °C | 0.9 | – | pF |
| f_T | transition frequency | $I_C = 25$ mA; $V_{CE} = 5$ V; $f = 500$ MHz; $T_j = 25$ °C | 2 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 30$ mA; $V_{CE} = 5$ V; $f = 800$ MHz; $T_{amb} = 25$ °C | 10.5 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|---------------------------|---------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 18 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 50 | mA |
| I_{CM} | peak collector current | $f > 1$ MHz | – | 100 | mA |
| P_{tot} | total power dissipation | $T_s \leq 85$ °C (note 1) | – | 250 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 150 | °C |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 2 GHz wideband transistor

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THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|----------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | $T_s \leq 85\text{ °C}$; note 1 | 260 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

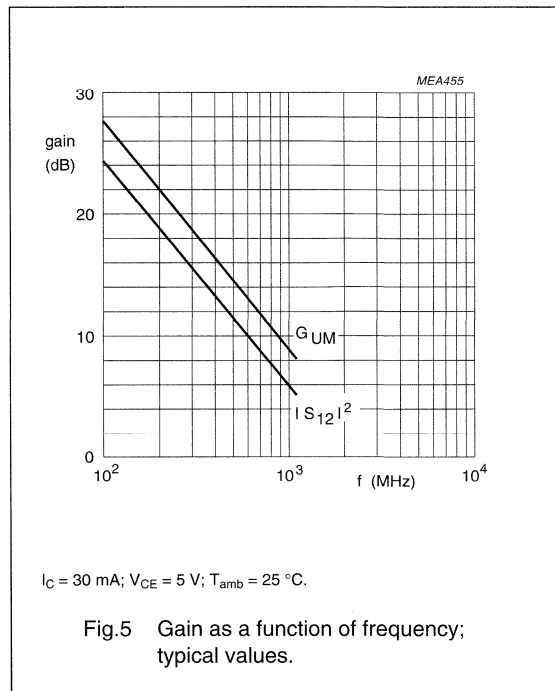
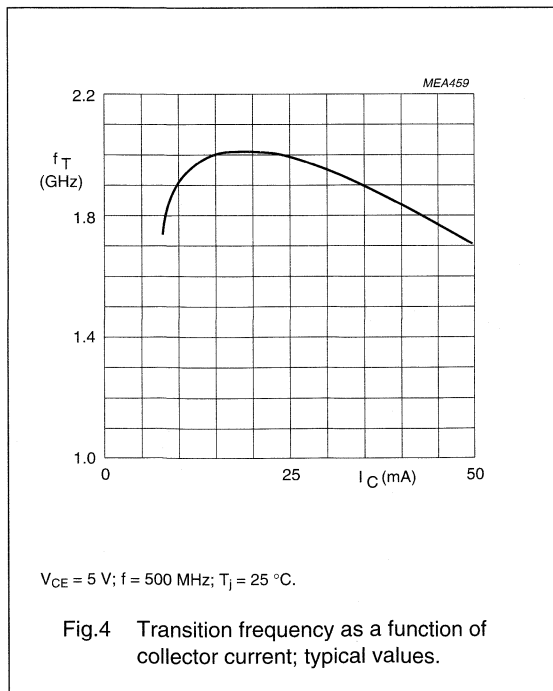
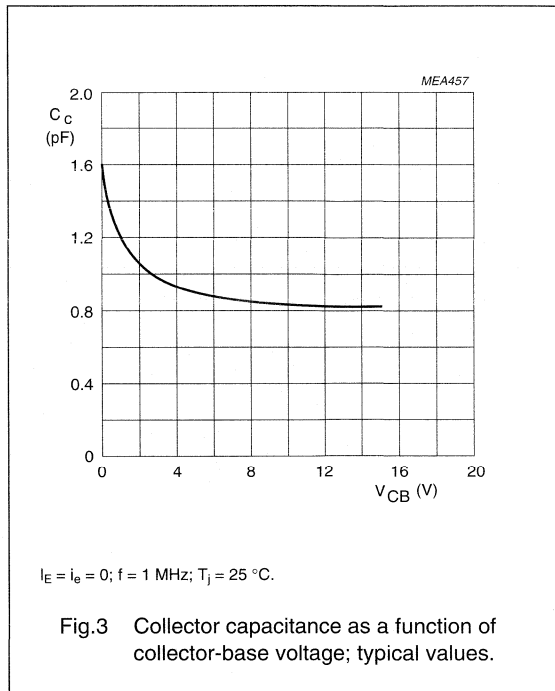
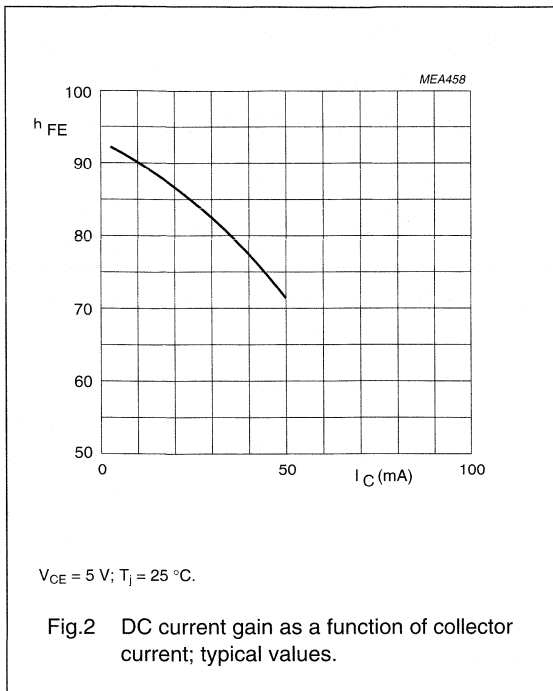
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 25\text{ mA}$; $V_{CE} = 5\text{ V}$; see Fig.2 | 25 | – | – | |
| | | $I_C = 50\text{ mA}$; $V_{CE} = 5\text{ V}$; see Fig.2 | 25 | – | – | |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 5\text{ V}$; $f = 1\text{ MHz}$; see Fig.3 | – | 0.9 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.5 | – | pF |
| C_{re} | feedback capacitance | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 0.9 | – | pF |
| f_T | transition frequency | $I_C = 25\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; see Fig.4 | – | 2 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$; see Fig.5 | – | 10.5 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$; see Fig.6 | – | – | 5 | dB |

Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB.

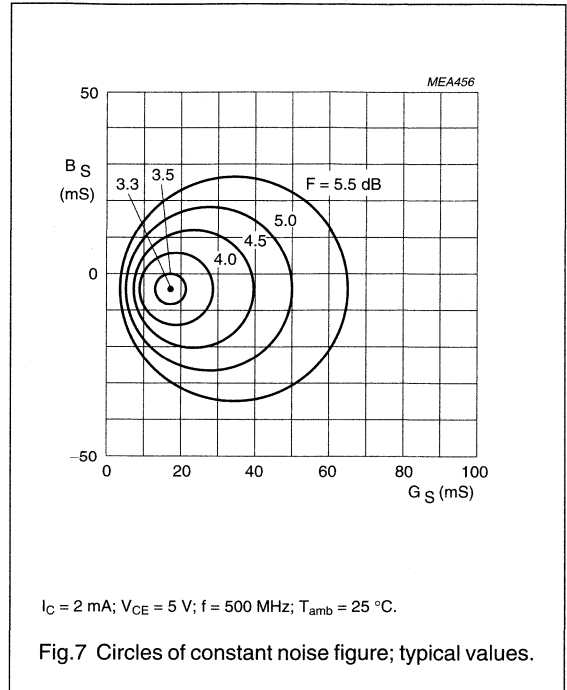
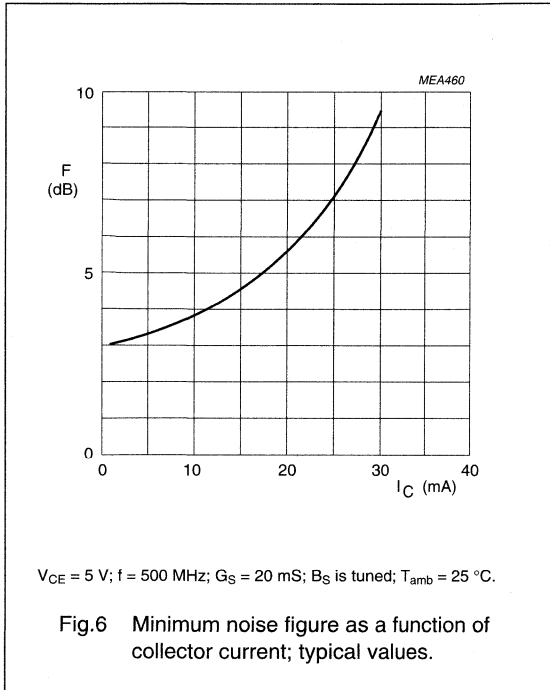
NPN 2 GHz wideband transistor

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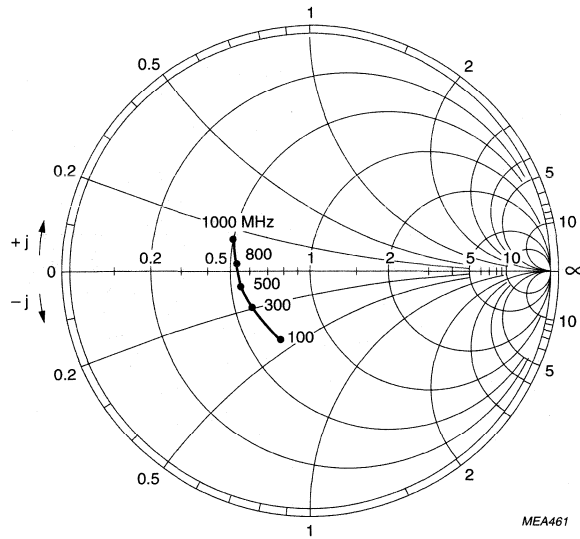
NPN 2 GHz wideband transistor

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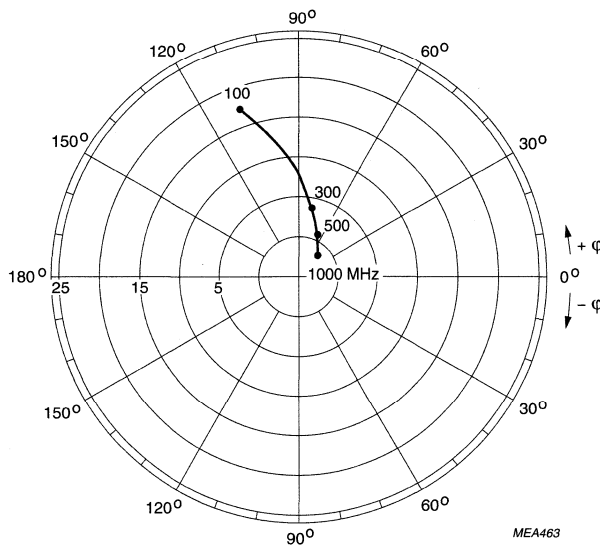
NPN 2 GHz wideband transistor

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$I_C = 30 \text{ mA}$; $V_{CE} = 5 \text{ V}$; $Z_0 = 50 \Omega$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.8 Common emitter input reflection coefficient (S_{11}).

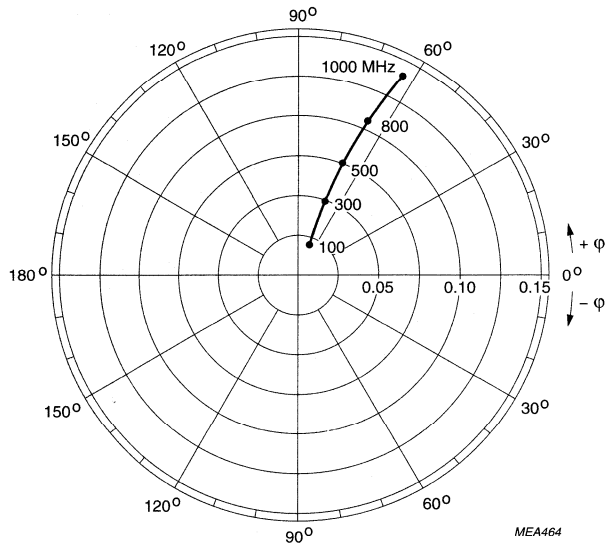


$I_C = 30 \text{ mA}$; $V_{CE} = 5 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.9 Common emitter forward transmission coefficient (S_{21}).

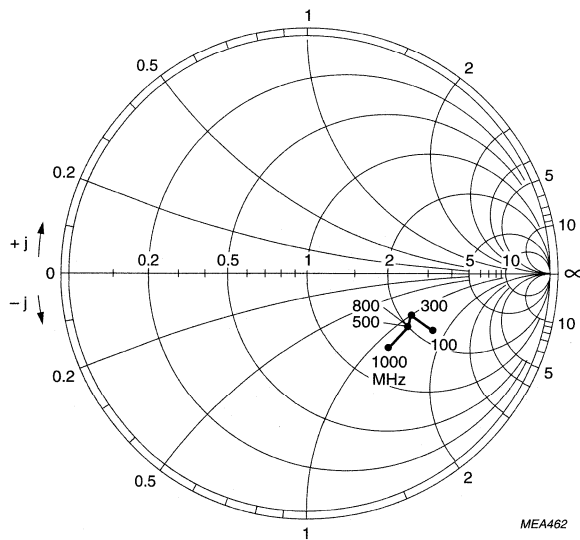
NPN 2 GHz wideband transistor

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$I_C = 30 \text{ mA}$; $V_{CE} = 5 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.10 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 30 \text{ mA}$; $V_{CE} = 5 \text{ V}$; $Z_0 = 50 \text{ } \Omega$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.11 Common emitter output reflection coefficient (S_{22}).

NPN 5 GHz wideband transistor

BFR92

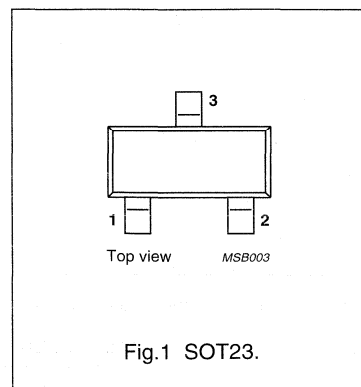
DESCRIPTION

NPN transistor in a plastic SOT23 envelope primarily intended for use in RF wideband amplifiers and oscillators. The transistor features low intermodulation distortion and high power gain; due to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

PNP complement is BFT92.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: P1p | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|
| V_{CB0} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| I_C | DC collector current | | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_s = 95\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| f_T | transition frequency | $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ }^\circ\text{C}$ | 5 | – | GHz |
| C_{re} | feedback capacitance | $I_C = 2\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ MHz}$ | 0.4 | – | pF |
| G_{UM} | maximum unilateral power gain | $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 18 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $Z_s = \text{opt.}$ | 2.4 | – | dB |
| V_o | output voltage | $d_{im} = -60\text{ dB}$; $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\text{ }\Omega$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f_{(p+q-r)} = 493.25\text{ MHz}$ | 150 | – | mV |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|---|------|------|------------------|
| V_{CB0} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_s = 95\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | 150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 175 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 5 GHz wideband transistor

BFR92

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|-------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 95\text{ °C}$; note 1 | 260 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

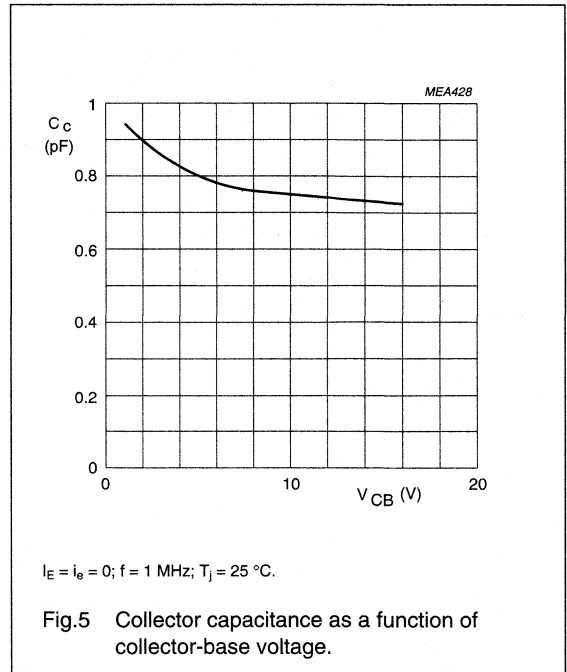
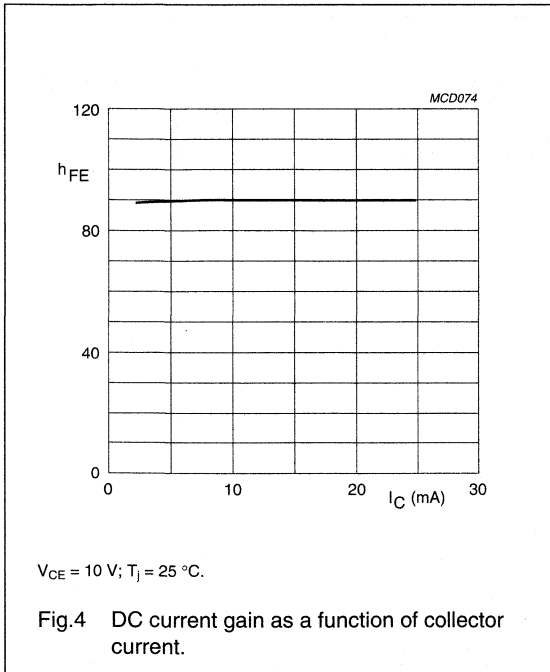
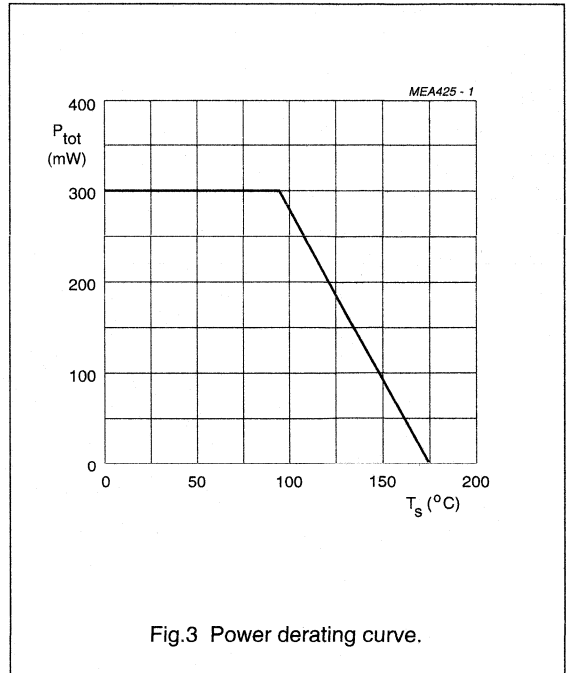
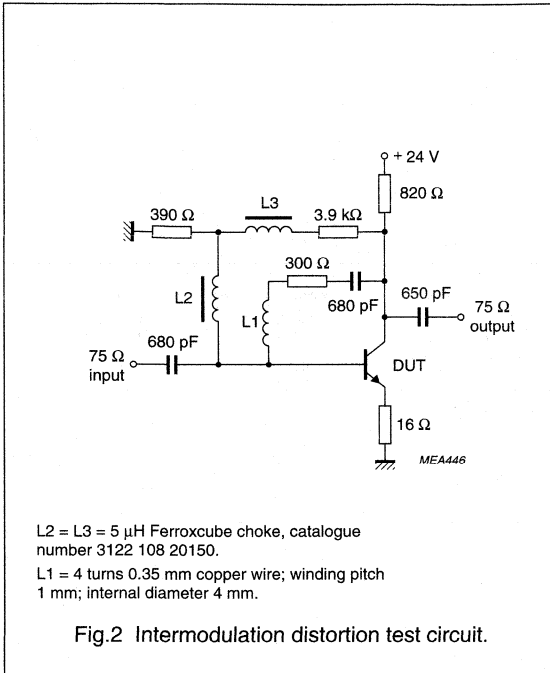
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$ | 40 | 90 | – | |
| f_T | transition frequency | $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$ | – | 5 | – | GHz |
| C_C | collector capacitance | $I_E = I_C = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.75 | – | pF |
| C_e | emitter capacitance | $I_C = I_C = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.8 | – | pF |
| C_{re} | feedback capacitance | $I_C = 2\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 0.4 | – | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 18 | – | dB |
| F | noise figure (see Fig.2 and note 2) | $I_C = 2\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$; $Z_s = \text{opt.}$ | – | 2.4 | – | dB |
| V_o | output voltage | note 3 | – | 150 | – | mV |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB
- Crystal mounted in a SOT37 envelope (BFR90).
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$;
 $V_p = V_o$ at $d_{im} = -60\text{ dB}$; $f_p = 495.25\text{ MHz}$;
 $V_q = V_o - 6\text{ dB}$; $f_q = 503.25\text{ MHz}$;
 $V_r = V_o - 6\text{ dB}$; $f_r = 505.25\text{ MHz}$;
 measured at $f_{(p+q-r)} = 493.25\text{ MHz}$.

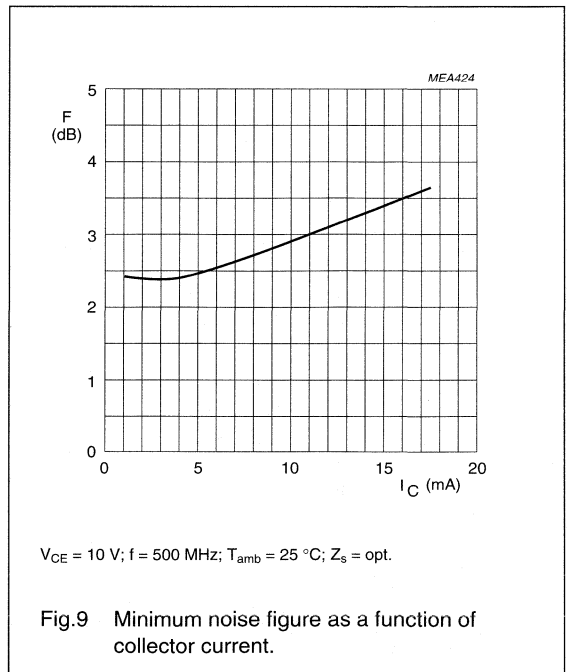
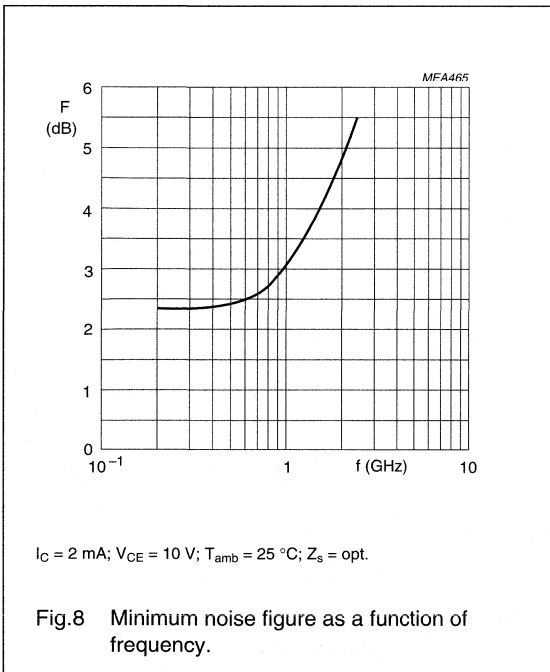
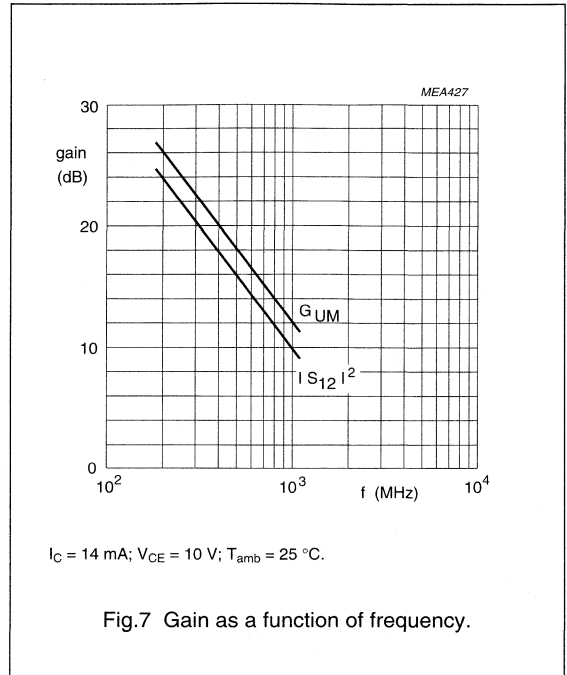
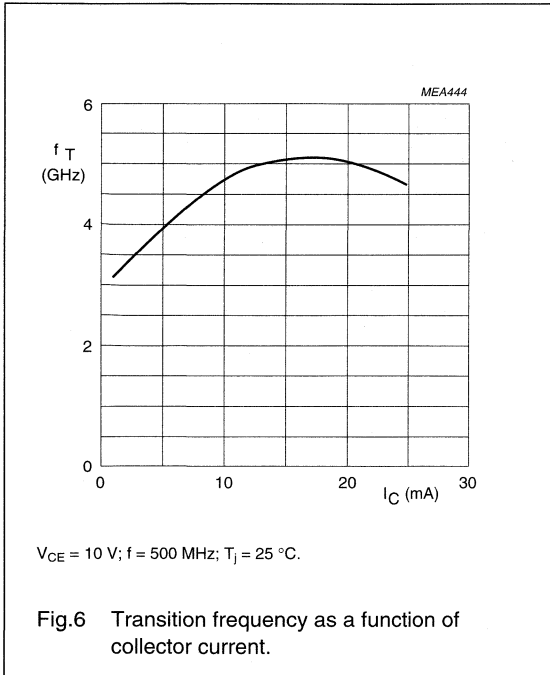
NPN 5 GHz wideband transistor

BFR92



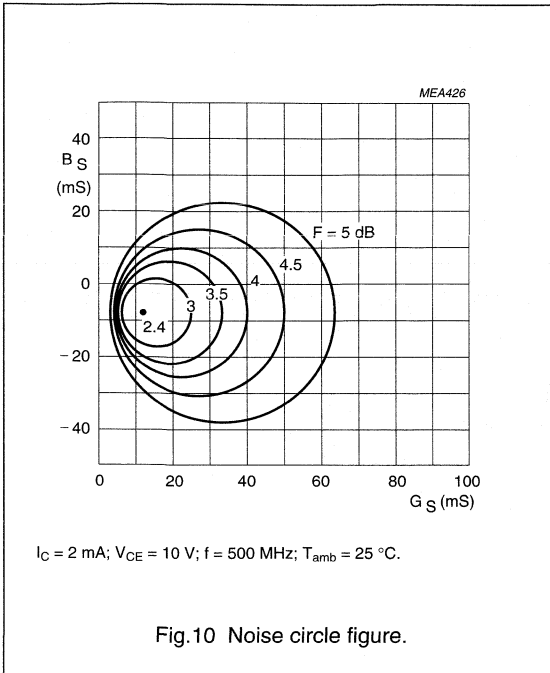
NPN 5 GHz wideband transistor

BFR92



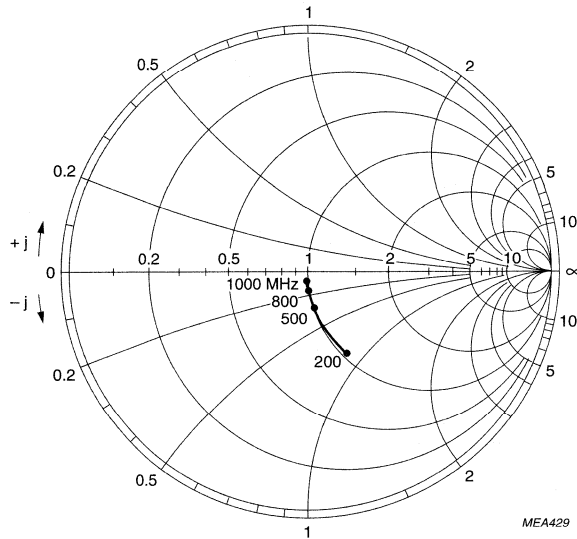
NPN 5 GHz wideband transistor

BFR92



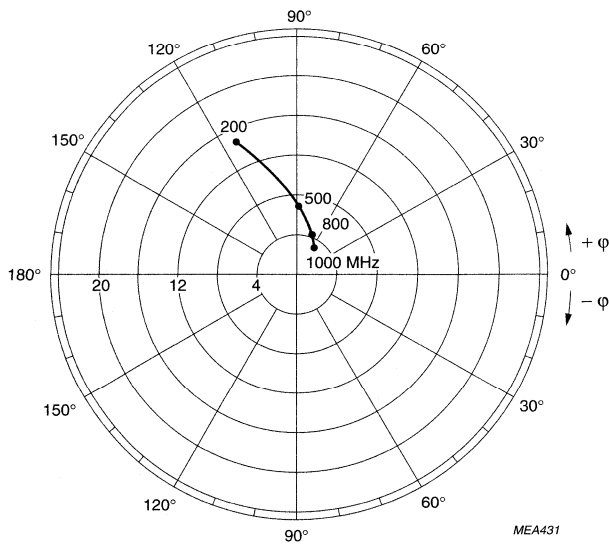
NPN 5 GHz wideband transistor

BFR92



$I_C = 14 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_o = 50 \text{ } \Omega$.

Fig.11 Common emitter input reflection coefficient (S_{11}).

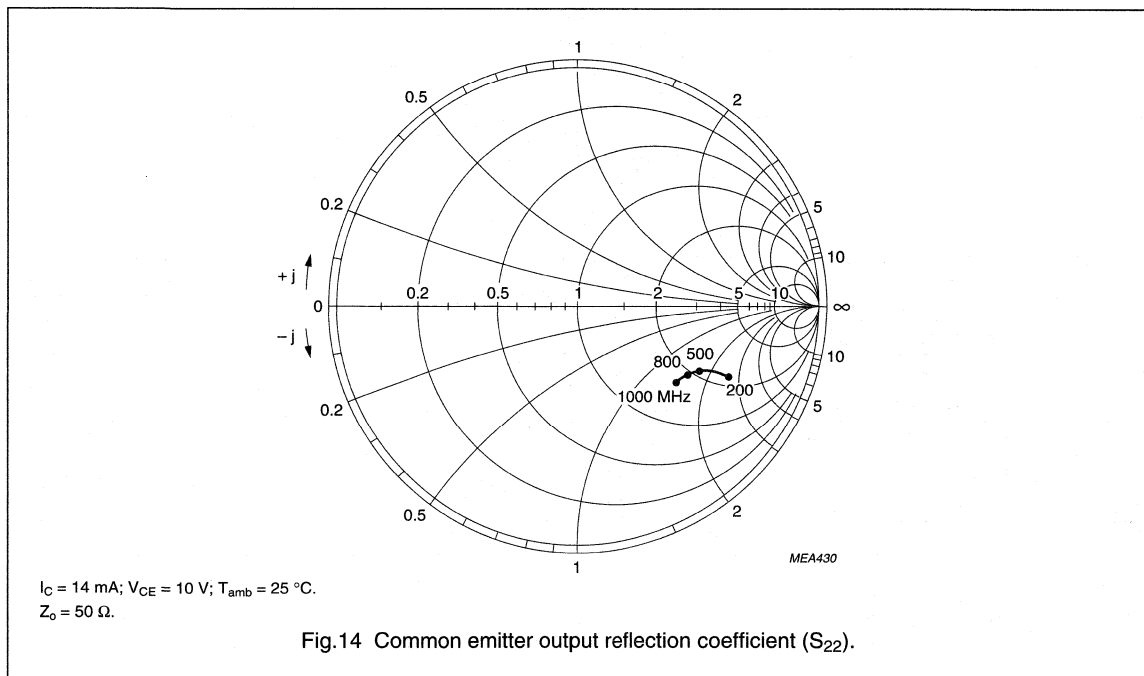
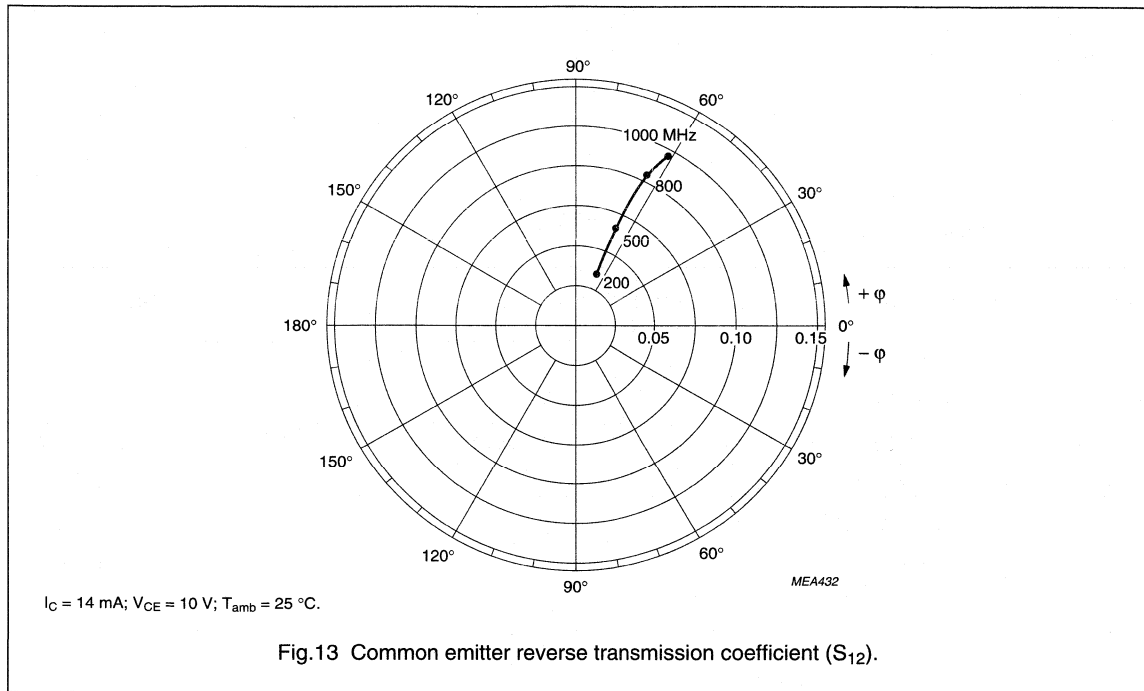


$I_C = 14 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.12 Common emitter forward transmission coefficient (S_{21}).

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BFR92



NPN 5 GHz wideband transistor

BFR92A

FEATURES

- High power gain
- Low noise figure
- Low intermodulation distortion.

APPLICATIONS

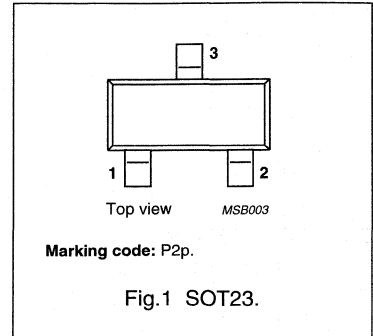
- RF wideband amplifiers and oscillators.

DESCRIPTION

NPN wideband transistor in a plastic SOT23 package.
PNP complement: BFT92.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | | – | 20 | V |
| V_{CEO} | collector-emitter voltage | | – | 15 | V |
| I_C | collector current (DC) | | – | 25 | mA |
| P_{tot} | total power dissipation | $T_s \leq 95\text{ }^\circ\text{C}$ | – | 300 | mW |
| C_{re} | feedback capacitance | $I_C = i_c = 0$; $V_{CE} = 10\text{ V}$; $f = 1\text{ MHz}$ | 0.35 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$ | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 14 | – | dB |
| | | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 8 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $\Gamma_s = \Gamma_{opt}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 2.1 | – | dB |
| V_O | output voltage | $d_{im} = -60\text{ dB}$; $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\text{ }\Omega$; $f_p + f_q - f_r = 793.25\text{ MHz}$ | 150 | – | mV |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|---|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | collector current (DC) | | – | 25 | mA |
| P_{tot} | total power dissipation | $T_s \leq 95\text{ }^\circ\text{C}$; note 1; see Fig.3 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 175 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 5 GHz wideband transistor

BFR92A

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|-------------|---|--|-------|------|
| R_{thj-s} | thermal resistance from junction to soldering point | $T_s \leq 95\text{ }^\circ\text{C}$; note 1 | 260 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

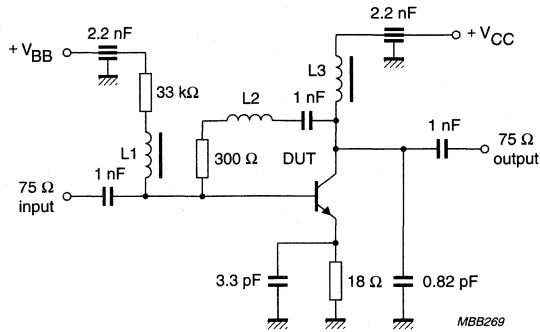
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|------|
| I_{CBO} | collector leakage current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; see Fig.4 | 40 | 90 | – | |
| C_c | collector capacitance | $I_E = I_E = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$; see Fig.5 | – | 0.6 | – | pF |
| C_e | emitter capacitance | $I_C = I_C = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.2 | – | pF |
| C_{re} | feedback capacitance | $I_C = I_C = 0$; $V_{CE} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.35 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$; see Fig.6 | – | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 14 | – | dB |
| | | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 8 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $\Gamma_s = \Gamma_{opt}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see Figs 13 and 14 | – | 2.1 | – | dB |
| | | $I_C = 5\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 2\text{ GHz}$; $\Gamma_s = \Gamma_{opt}$; $T_{amb} = 25\text{ }^\circ\text{C}$; see Figs 13 and 14 | – | 3 | – | dB |
| V_O | output voltage | notes 2 and 3 | – | 150 | – | mV |
| d_2 | second order intermodulation distortion | notes 2 and 4; see Fig.16 | – | –50 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right)$ dB.
- Measured on the same die in a SOT37 package (BFR90A).
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\ \Omega$; $VSWR < 2$; $T_{amb} = 25\text{ }^\circ\text{C}$
 $V_p = V_O$ at $d_{im} = -60\text{ dB}$; $f_p = 795.25\text{ MHz}$;
 $V_q = V_O - 6\text{ dB}$; $f_q = 803.25\text{ MHz}$;
 $V_r = V_O - 6\text{ dB}$; $f_r = 805.25\text{ MHz}$;
measured at $f_p + f_q - f_r = 793.25\text{ MHz}$.
- $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\ \Omega$; $VSWR < 2$; $T_{amb} = 25\text{ }^\circ\text{C}$
 $V_p = 60\text{ mV}$ at $f_p = 250\text{ MHz}$;
 $V_q = 60\text{ mV}$ at $f_q = 560\text{ MHz}$;
measured at $f_p + f_q = 810\text{ MHz}$.

NPN 5 GHz wideband transistor

BFR92A



L1 = L3 = 5 μH choke.
 L2 = 3 turns 0.4 mm copper wire, internal diameter 3 mm, winding pitch 1 mm.

Fig.2 Intermodulation distortion and second harmonic distortion MATV test circuit.

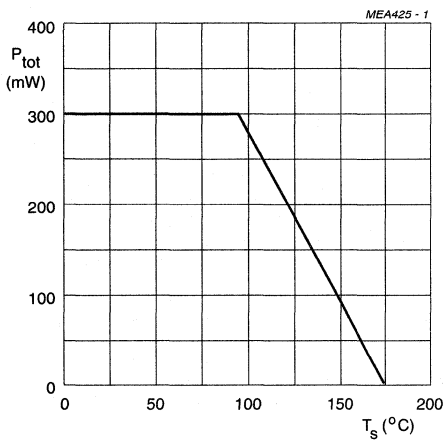
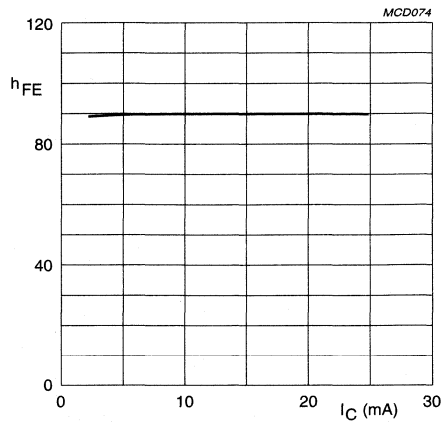


Fig.3 Power derating curve.

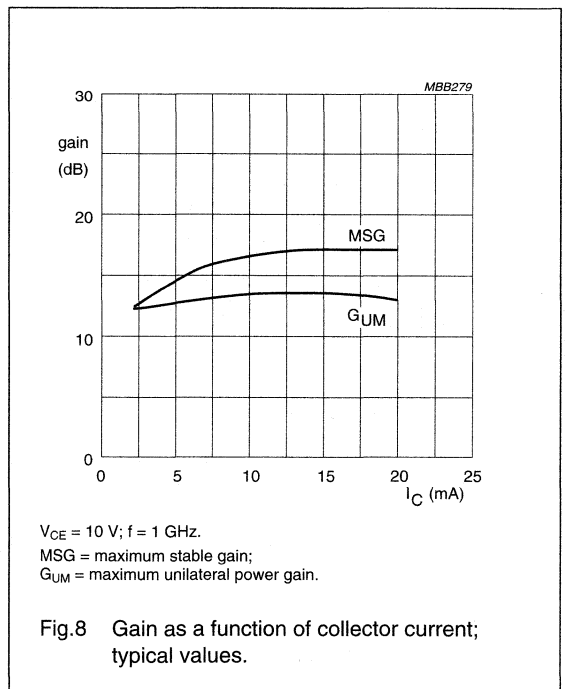
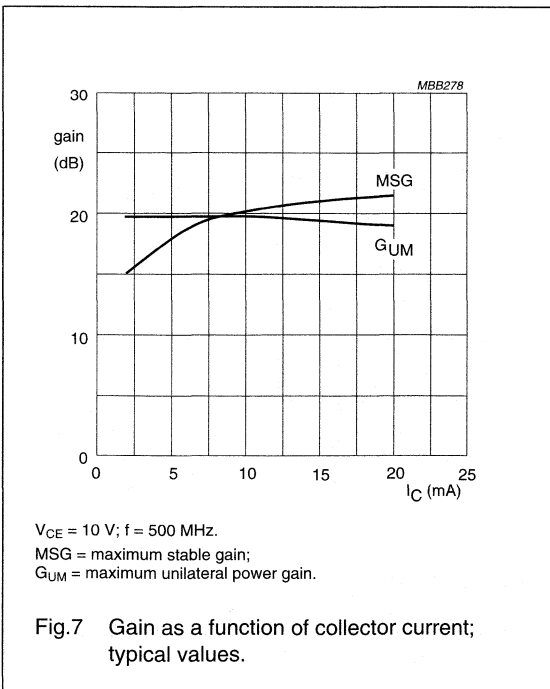
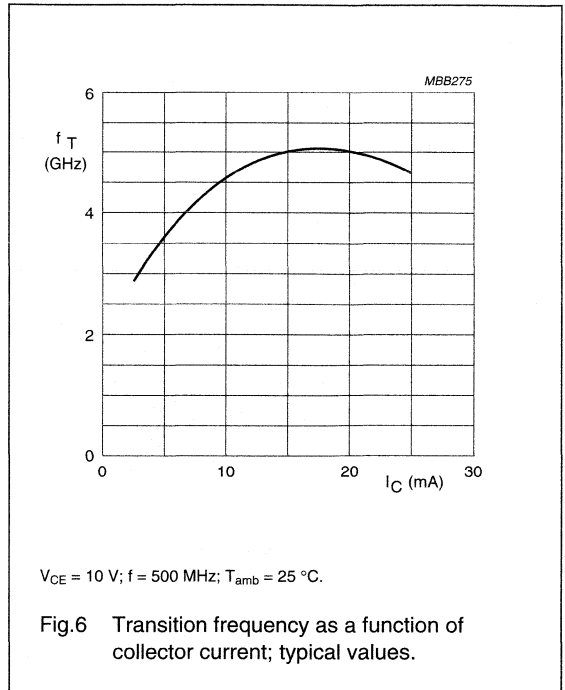
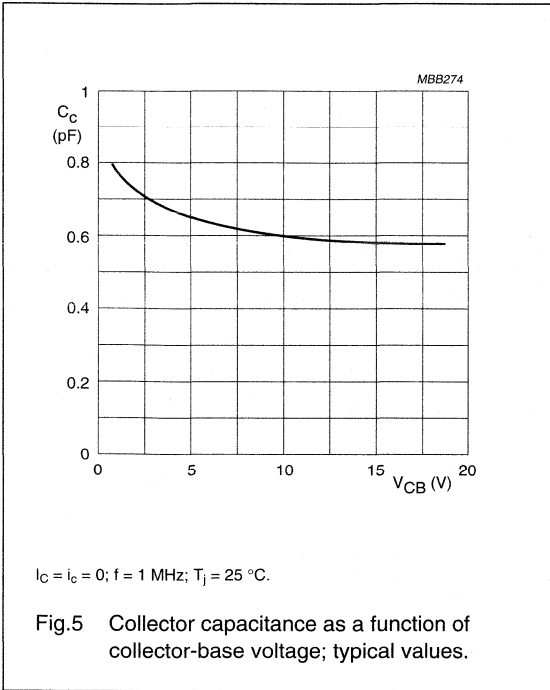


V_{CE} = 10 V; T_J = 25 °C.

Fig.4 DC current gain as a function of collector current; typical values.

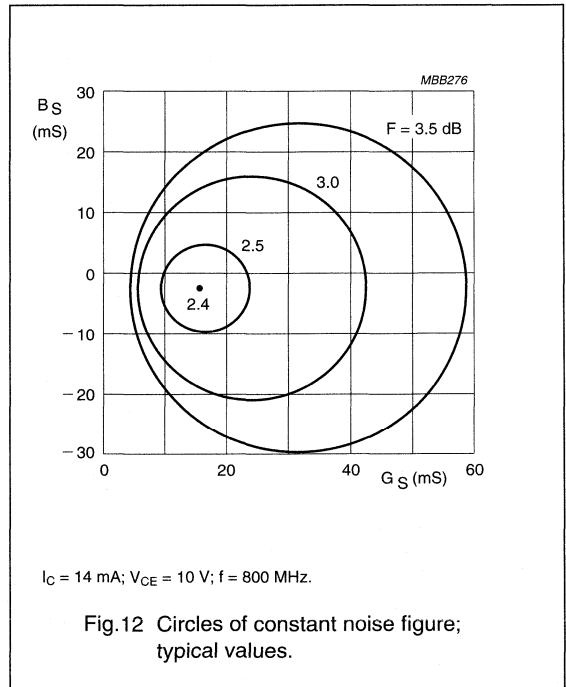
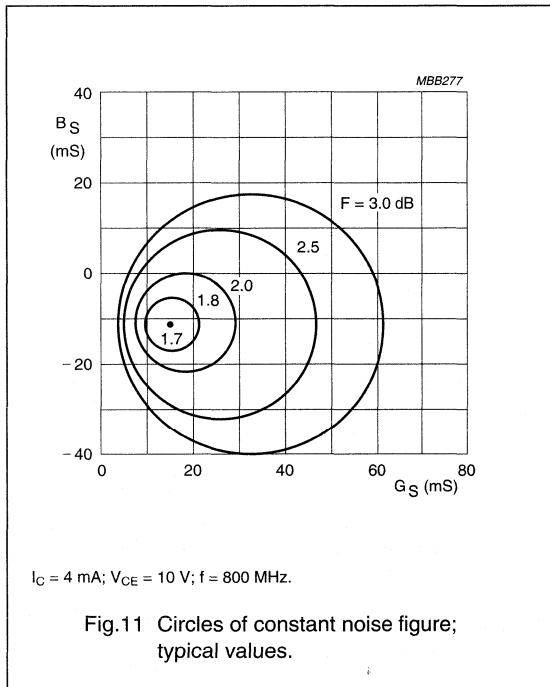
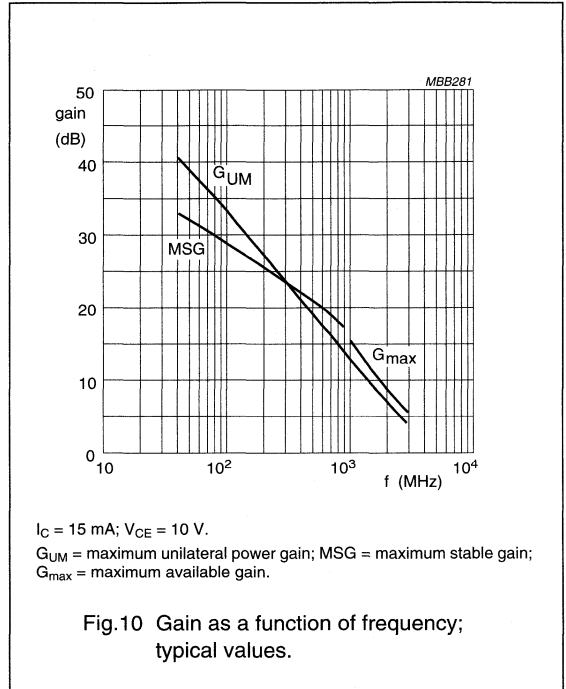
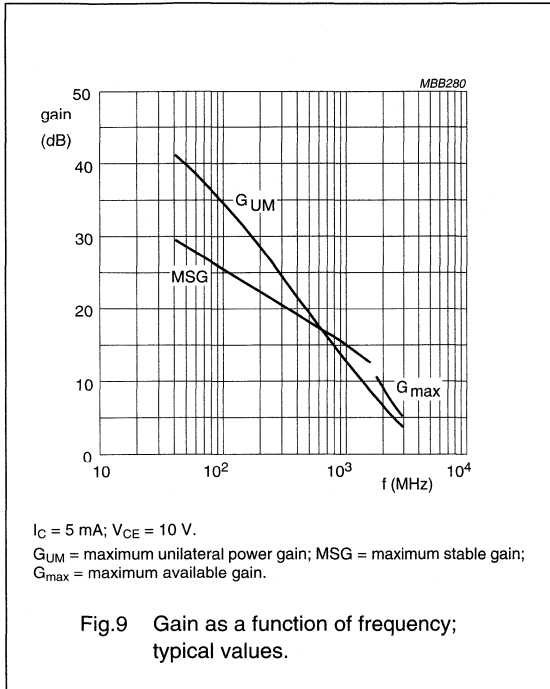
NPN 5 GHz wideband transistor

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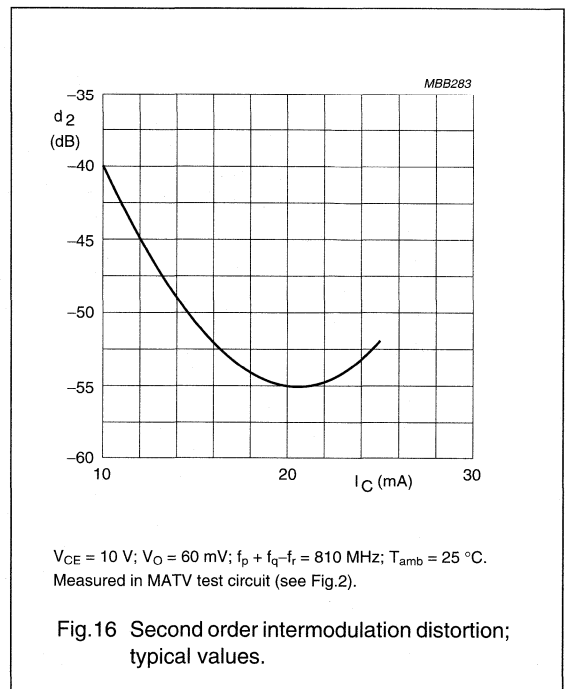
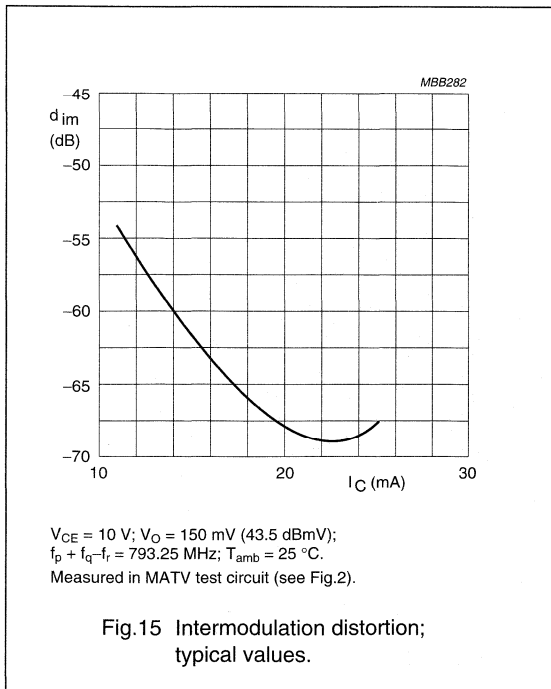
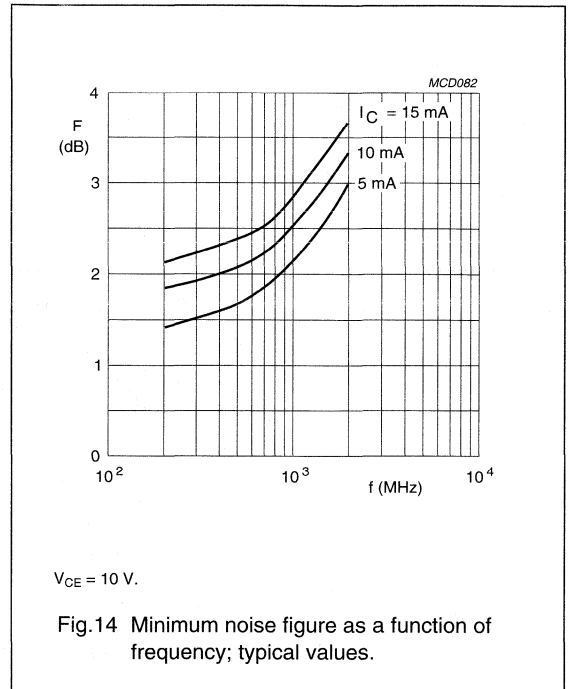
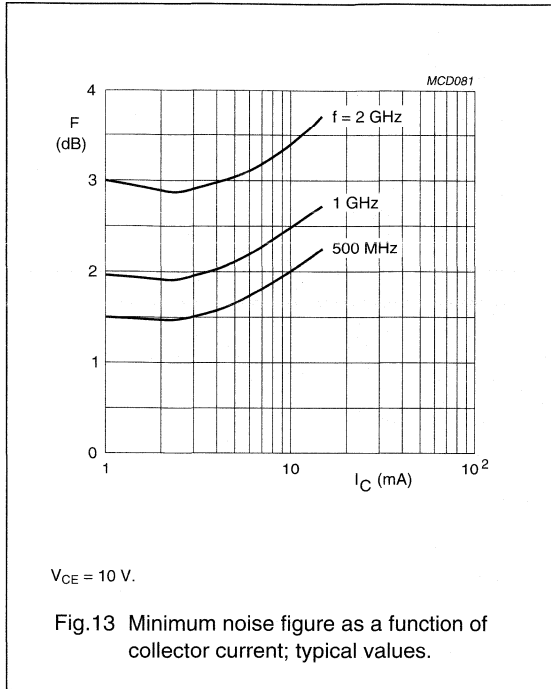
NPN 5 GHz wideband transistor

BFR92A



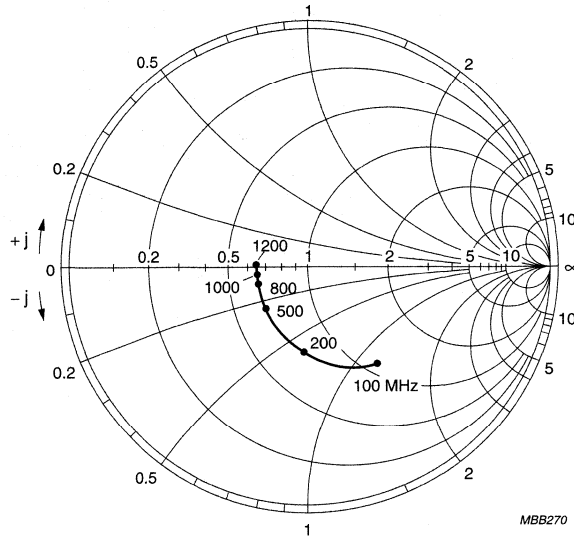
NPN 5 GHz wideband transistor

BFR92A



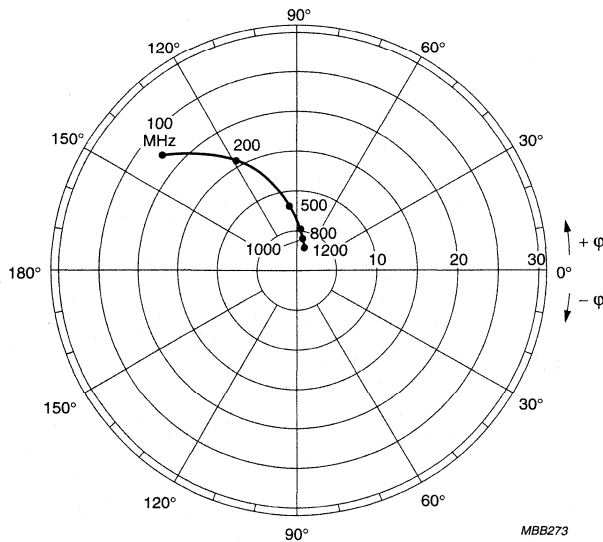
NPN 5 GHz wideband transistor

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$I_C = 14 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $Z_o = 50 \Omega$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.17 Common emitter input reflection coefficient (S_{11}); typical values.

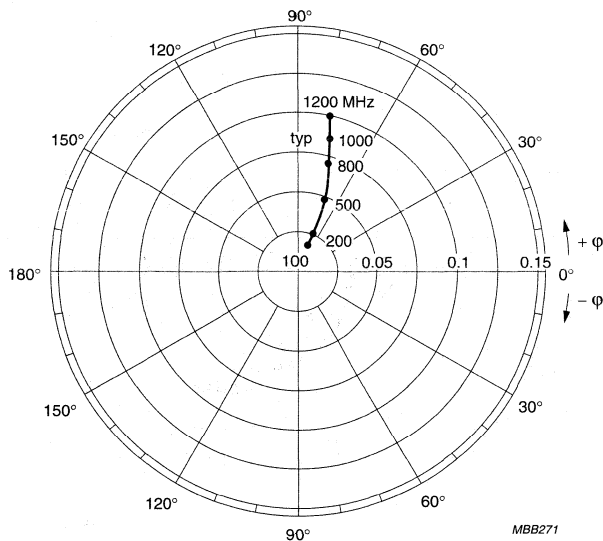


$I_C = 14 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.18 Common emitter forward transmission coefficient (S_{21}); typical values.

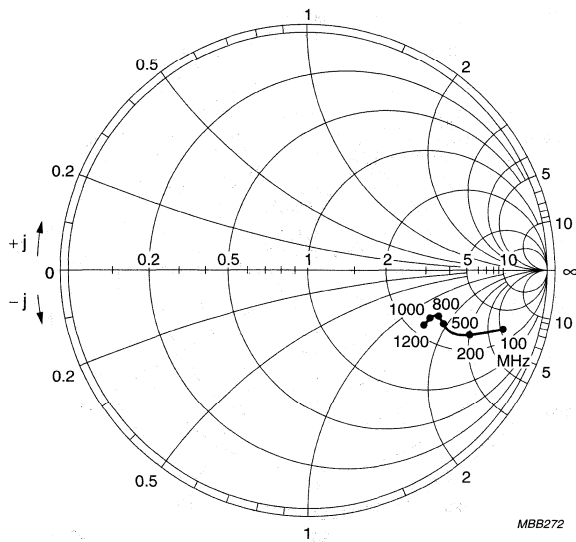
NPN 5 GHz wideband transistor

BFR92A



$I_C = 14 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.19 Common emitter reverse transmission coefficient (S_{12}); typical values.



$I_C = 14 \text{ mA}$; $V_{CE} = 10 \text{ V}$; $Z_0 = 50 \text{ } \Omega$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.20 Common emitter output reflection coefficient (S_{22}); typical values.

NPN 5 GHz wideband transistor

BFR92AW

FEATURES

- High power gain
- Gold metallization ensures excellent reliability
- SOT323 (S-mini) package.

APPLICATIONS

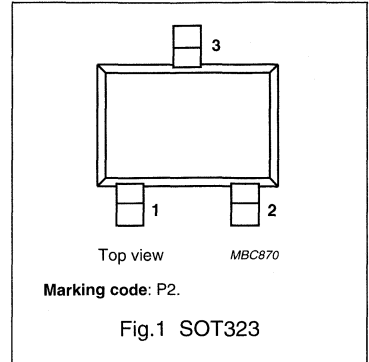
It is designed for use in RF amplifiers, mixers and oscillators with signal frequencies up to 1 GHz.

DESCRIPTION

Silicon NPN transistor encapsulated in a plastic SOT323 (S-mini) package. The BFR92AW uses the same crystal as the SOT23 version, BFR92A.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | collector current (DC) | | – | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_s = 93\text{ }^\circ\text{C}$; note 1 | – | – | 300 | mW |
| h_{FE} | current gain | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$ | 40 | 90 | – | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 10\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 0.35 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 500\text{ MHz}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 14 | – | dB |
| | | $I_C = 15\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 8 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 1\text{ GHz}$; $\Gamma_s = \Gamma_{opt}$ | – | 2 | – | dB |
| T_j | junction temperature | | – | – | 150 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 5 GHz wideband transistor

BFR92AW

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

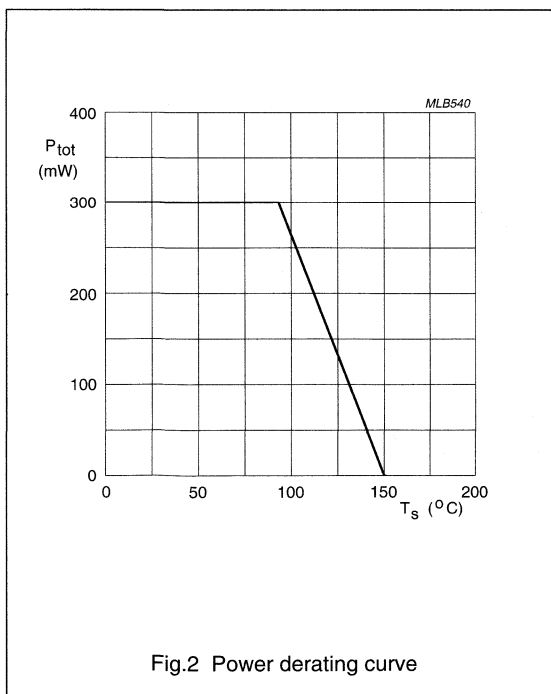
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | collector current (DC) | | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_s = 93\text{ }^\circ\text{C}$; see Fig.2; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 150 | $^\circ\text{C}$ |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 93\text{ }^\circ\text{C}$; note 1 | 190 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.



NPN 5 GHz wideband transistor

BFR92AW

CHARACTERISTICS

$T_j = 25\text{ °C}$ (unless otherwise specified).

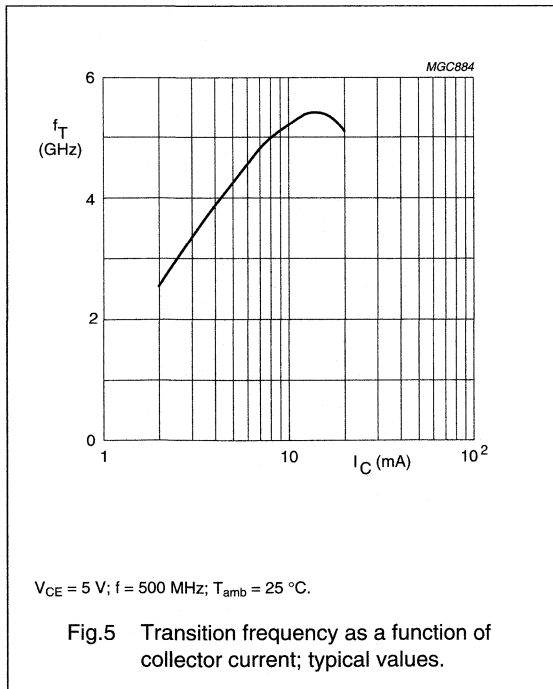
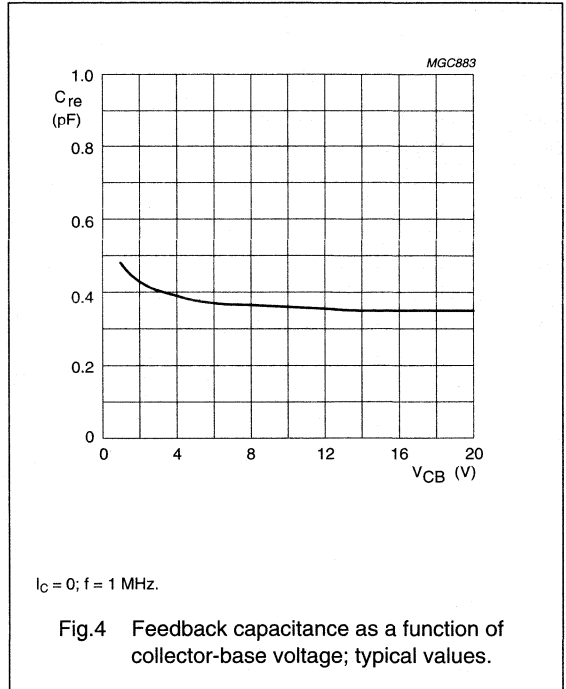
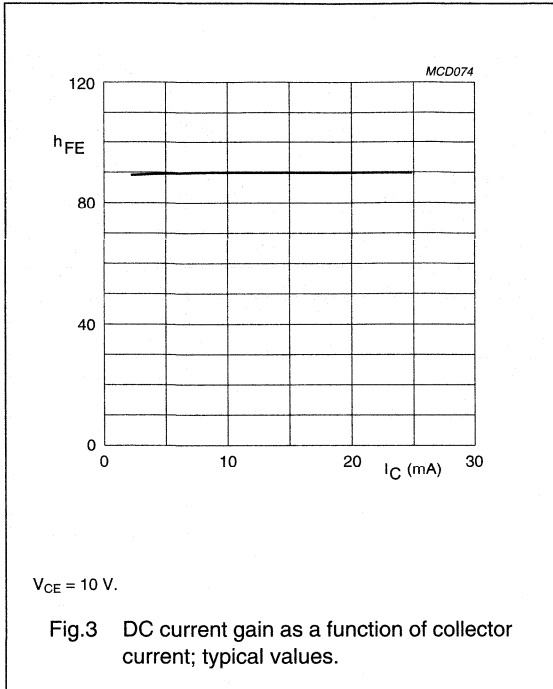
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------------------|---|------|------|------|------|
| I_{CBO} | collector leakage current | $I_E = 0; V_{CB} = 10\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 15\text{ mA}; V_{CE} = 10\text{ V}$ | 40 | 90 | – | |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 10\text{ V}; f = 1\text{ MHz}$ | – | 0.6 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 0.9 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = 10\text{ V}; f = 1\text{ MHz}$ | – | 0.35 | – | pF |
| f_T | transition frequency | $I_C = 15\text{ mA}; V_{CE} = 10\text{ V}; f = 500\text{ MHz}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 15\text{ mA}; V_{CE} = 10\text{ V};$ $f = 1\text{ GHz}; T_{amb} = 25\text{ °C}$ | – | 14 | – | dB |
| | | $I_C = 15\text{ mA}; V_{CE} = 10\text{ V};$ $f = 2\text{ GHz}; T_{amb} = 25\text{ °C}$ | – | 8 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}; V_{CE} = 10\text{ V};$ $f = 1\text{ GHz}; \Gamma_s = \Gamma_{opt}$ | – | 2 | – | dB |
| | | $I_C = 5\text{ mA}; V_{CE} = 10\text{ V};$ $f = 2\text{ GHz}; \Gamma_s = \Gamma_{opt}$ | – | 3 | – | dB |

Note

1. G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero and $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

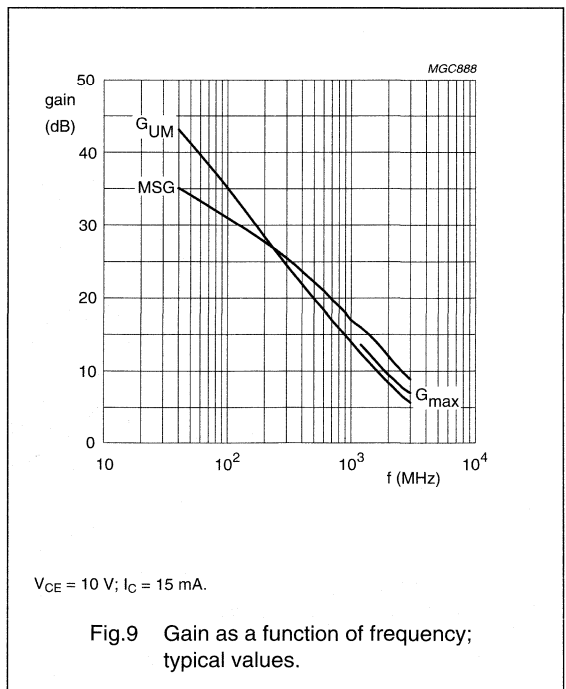
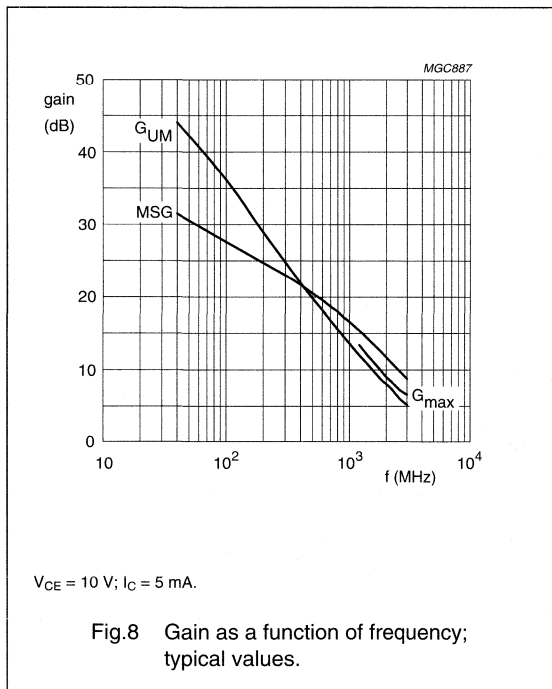
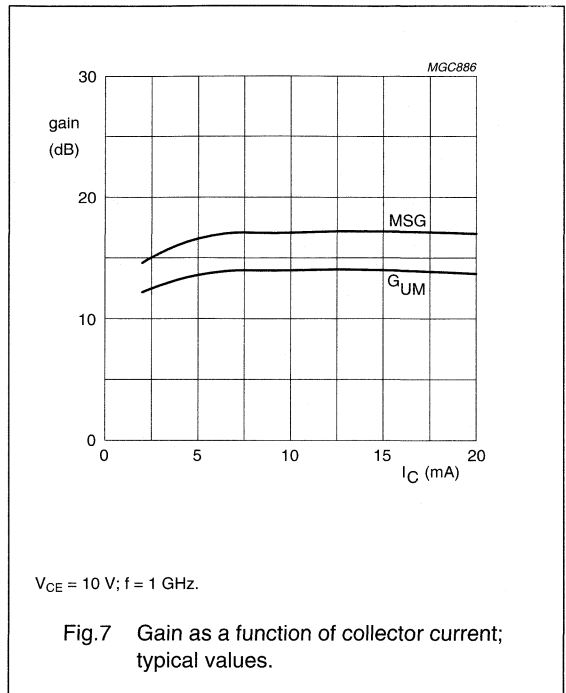
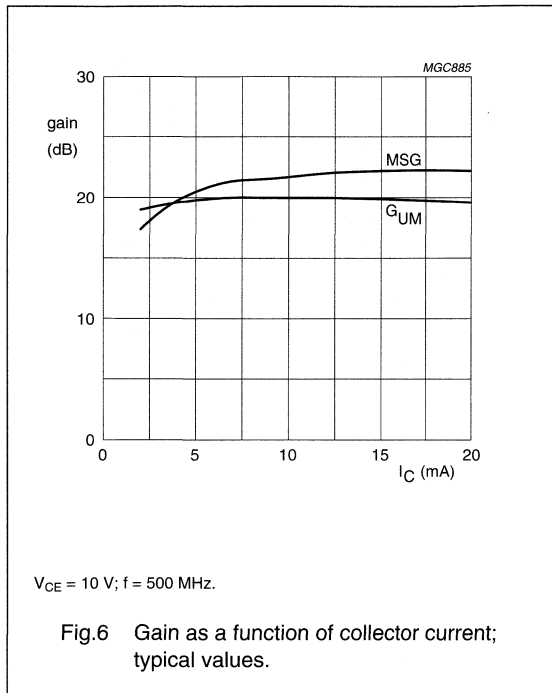
NPN 5 GHz wideband transistor

BFR92AW



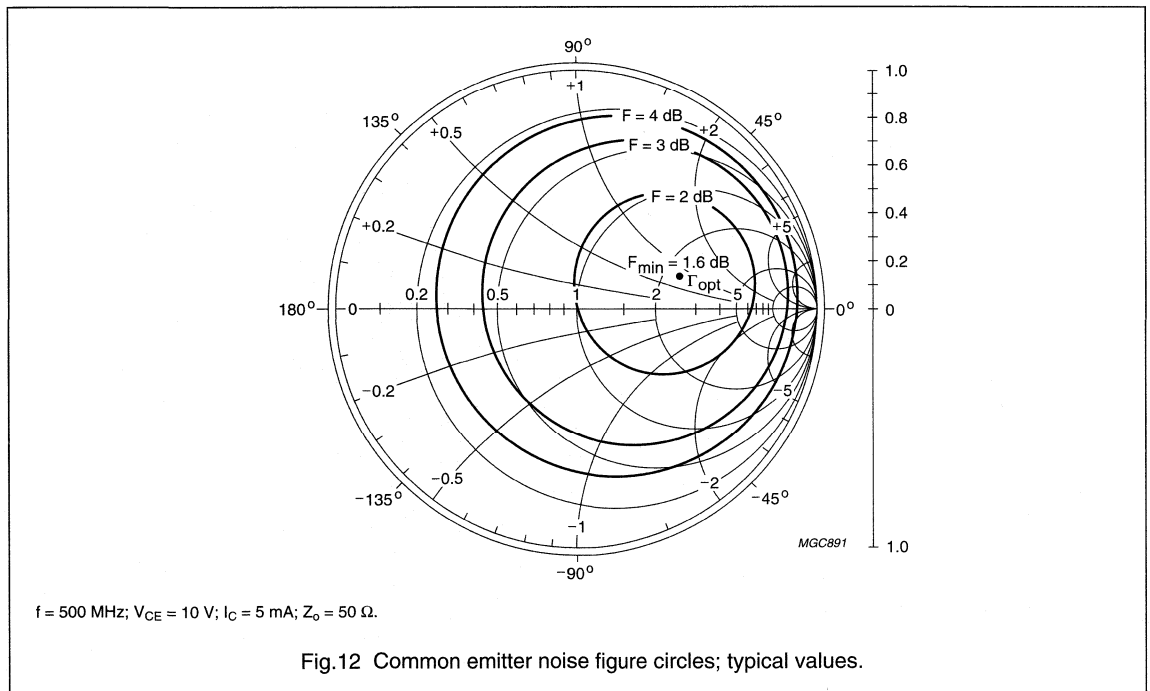
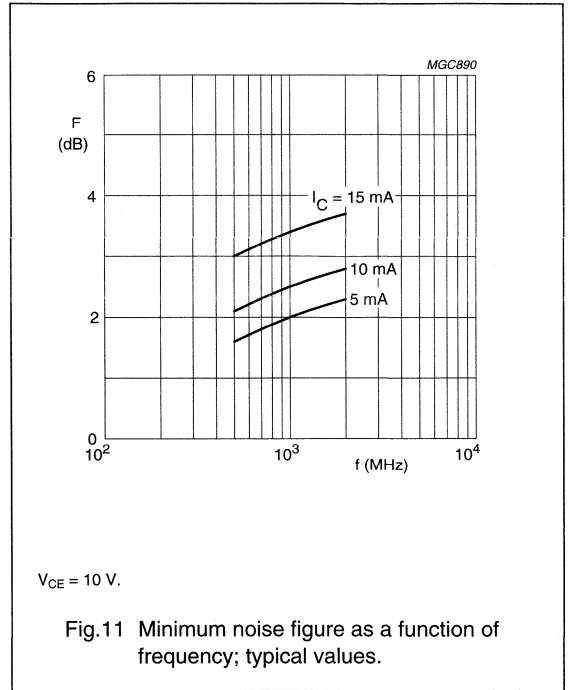
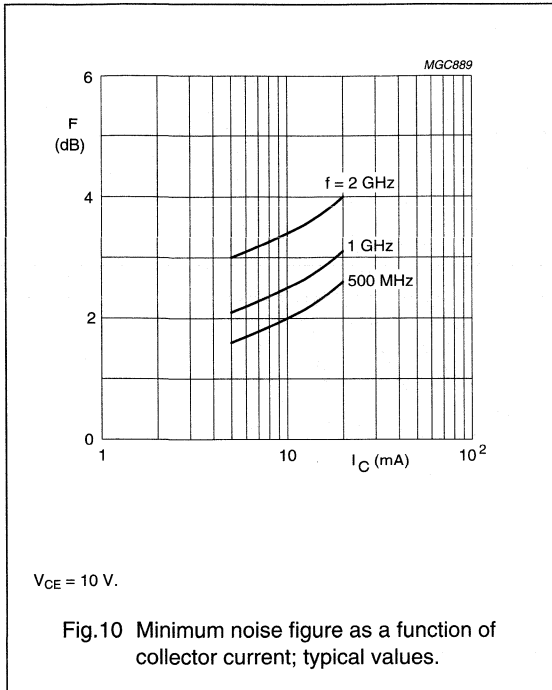
NPN 5 GHz wideband transistor

BFR92AW



NPN 5 GHz wideband transistor

BFR92AW



NPN 5 GHz wideband transistor

BFR92AW

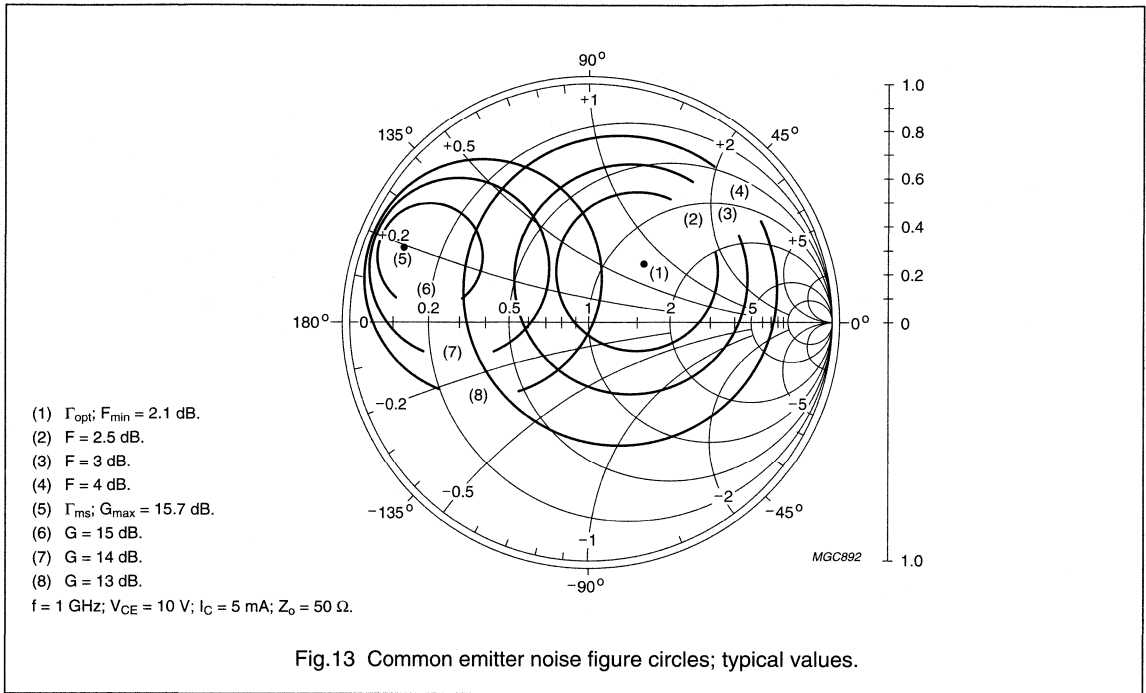


Fig.13 Common emitter noise figure circles; typical values.

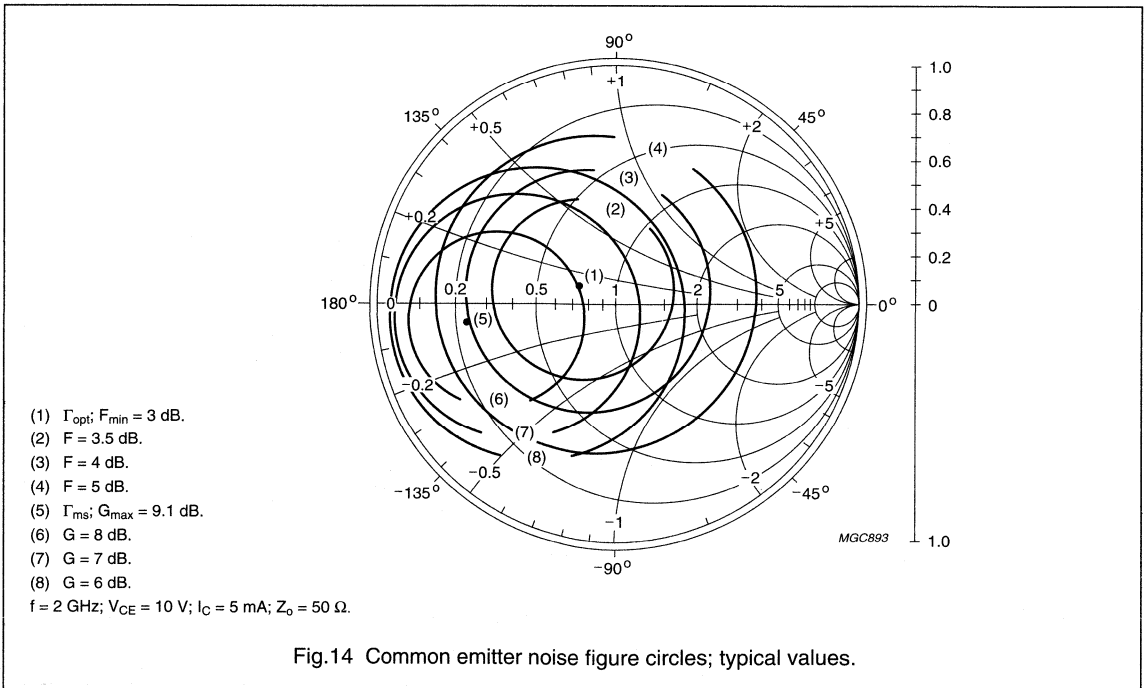
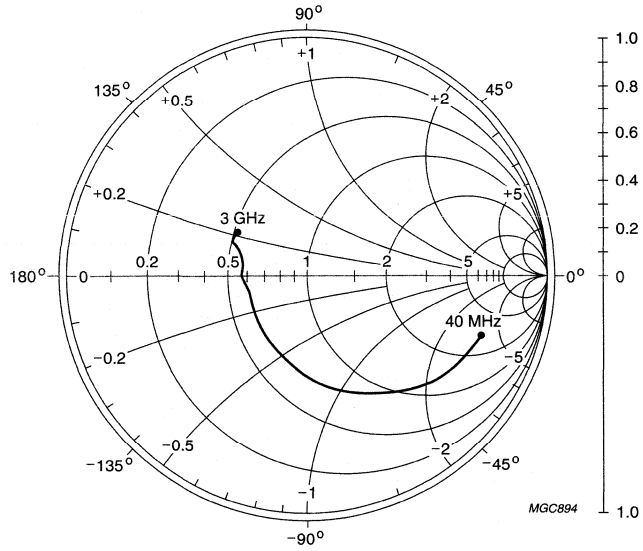


Fig.14 Common emitter noise figure circles; typical values.

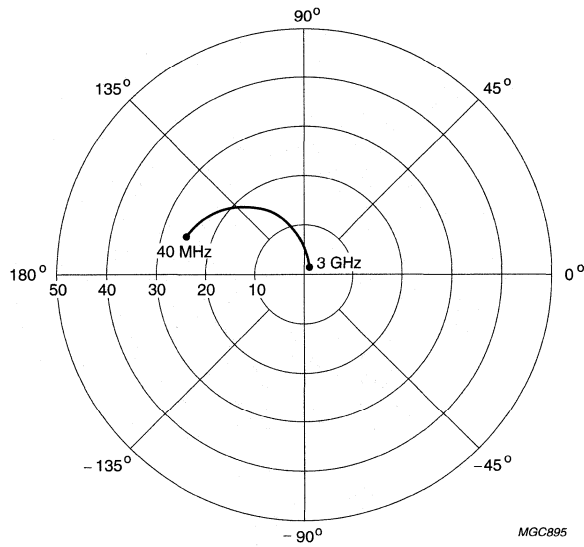
NPN 5 GHz wideband transistor

BFR92AW



$V_{CE} = 10 \text{ V}; I_C = 15 \text{ mA}; Z_0 = 50 \Omega.$

Fig.15 Common emitter input reflection coefficient (s_{11}); typical values.

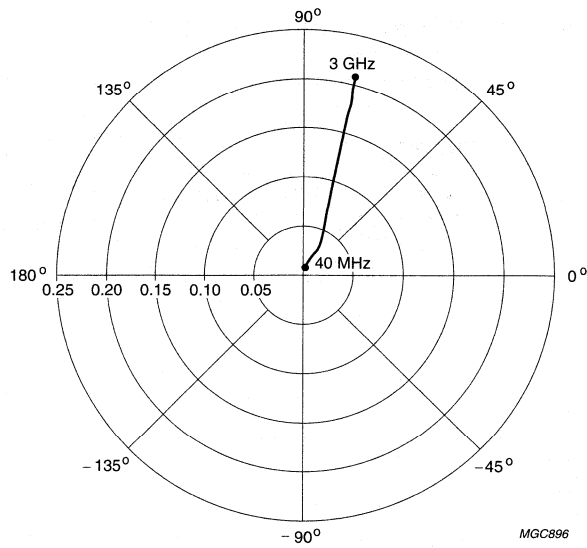


$V_{CE} = 10 \text{ V}; I_C = 15 \text{ mA}.$

Fig.16 Common emitter forward transmission coefficient (s_{21}); typical values.

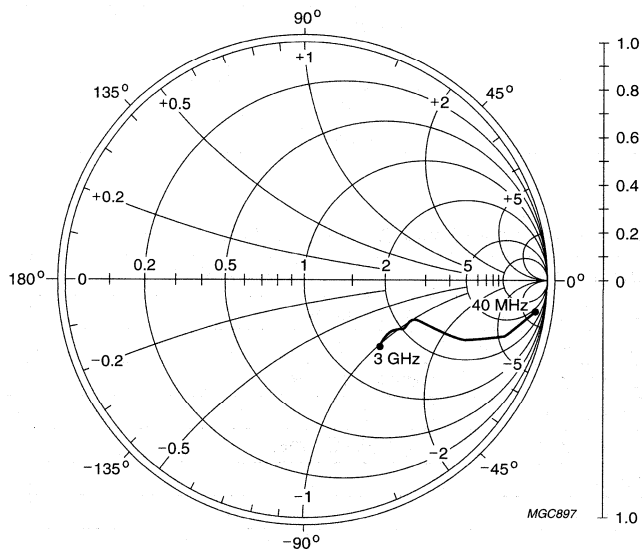
NPN 5 GHz wideband transistor

BFR92AW



$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}$.

Fig.17 Common emitter reverse transmission coefficient (s_{12}); typical values.



$V_{CE} = 10\text{ V}; I_C = 15\text{ mA}; Z_o = 50\ \Omega$.

Fig.18 Common emitter output reflection coefficient (s_{22}); typical values.

NPN 5 GHz wideband transistor

BFR93

FEATURES

- Very low intermodulation distortion
- High power gain
- Excellent wideband properties and low noise up to high frequencies due to its very high transition frequency.

APPLICATIONS

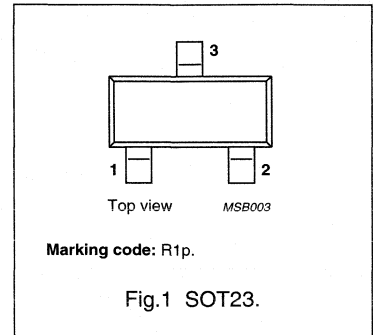
- RF wideband amplifiers and oscillators.

DESCRIPTION

NPN wideband transistor in a plastic SOT23 package.
PNP complement: BFT93.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 12 | V |
| I_C | collector current (DC) | | – | 35 | mA |
| P_{tot} | total power dissipation | $T_s \leq 95^\circ\text{C}$ | – | 300 | mW |
| C_{re} | feedback capacitance | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 1\text{ MHz}$ | 0.8 | – | pF |
| f_T | transition frequency | $I_C = 30\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}; T_j = 25^\circ\text{C}$ | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 30\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}; T_{amb} = 25^\circ\text{C}$ | 16.5 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}; T_{amb} = 25^\circ\text{C}$ | 1.9 | – | dB |
| d_{im} | intermodulation distortion | $I_C = 30\text{ mA}; V_{CE} = 5\text{ V}; R_L = 75\ \Omega; V_O = 300\text{ mV}; f_p + f_q - f_r = 493.25\text{ MHz}; T_{amb} = 25^\circ\text{C}$ | –60 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 12 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | collector current (DC) | | – | 35 | mA |
| P_{tot} | total power dissipation | $T_s \leq 95^\circ\text{C}; \text{note 1}$ | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 175 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 5 GHz wideband transistor

BFR93

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|----------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | $T_s \leq 95\text{ °C}$; note 1 | 260 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

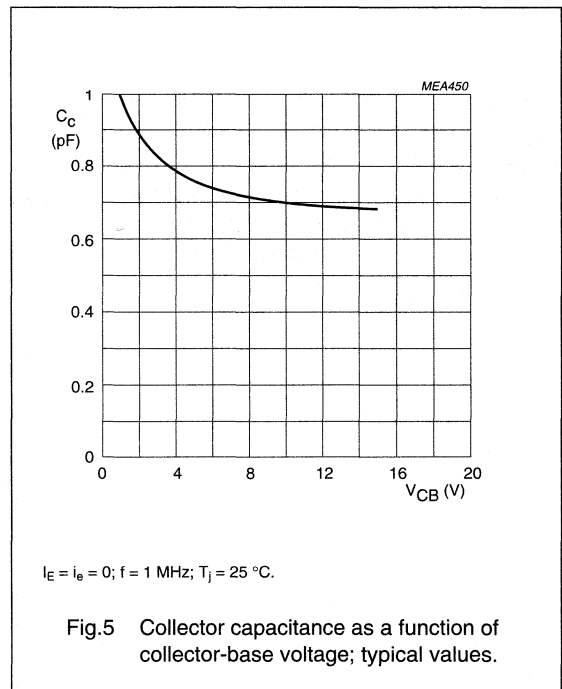
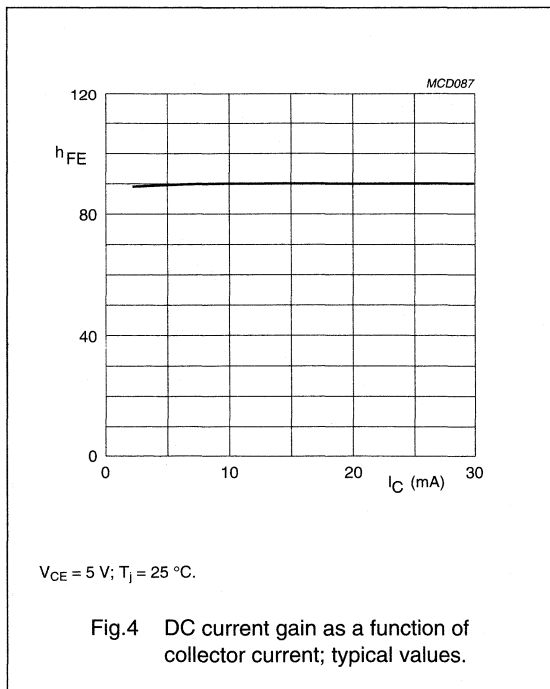
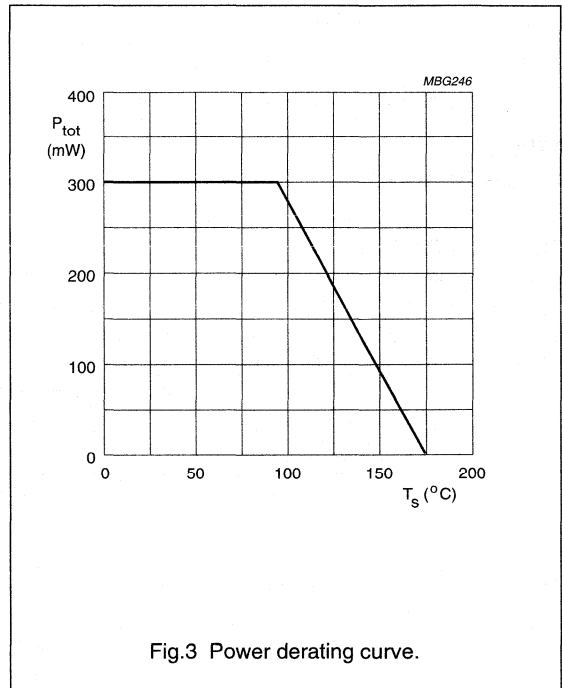
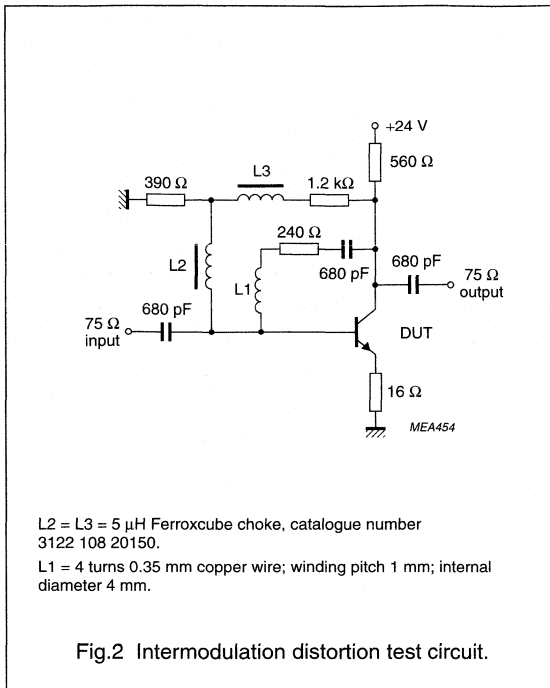
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$ | 40 | 90 | – | |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.8 | – | pF |
| C_{re} | feedback capacitance | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 0.8 | – | pF |
| f_T | transition frequency | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$ | – | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 16.5 | – | dB |
| F | noise figure (note 2) | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $Z_S = \text{opt.}$; $T_{amb} = 25\text{ °C}$ | – | 1.9 | – | dB |
| d_{im} | intermodulation distortion | note 3 | – | –60 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right)$ dB
- Die mounted in a SOT37 package (BFR91).
- $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $R_L = 75\ \Omega$; $VSWR < 2$; $T_{amb} = 25\text{ °C}$;
 $V_p = V_O = 300\text{ mV}$ at $f_p = 495.25\text{ MHz}$;
 $V_q = V_O - 6\text{ dB}$ at $f_q = 503.25\text{ MHz}$;
 $V_r = V_O - 6\text{ dB}$ at $f_r = 505.25\text{ MHz}$;
measured at $f_p + f_q - f_r = 493.25\text{ MHz}$.

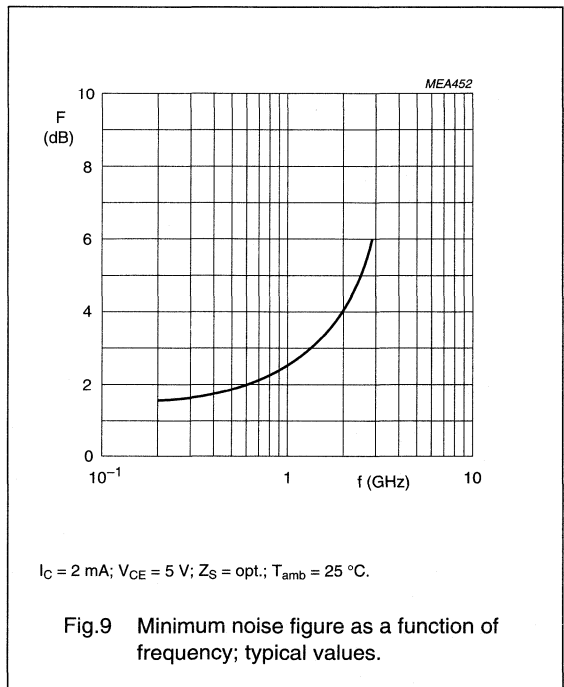
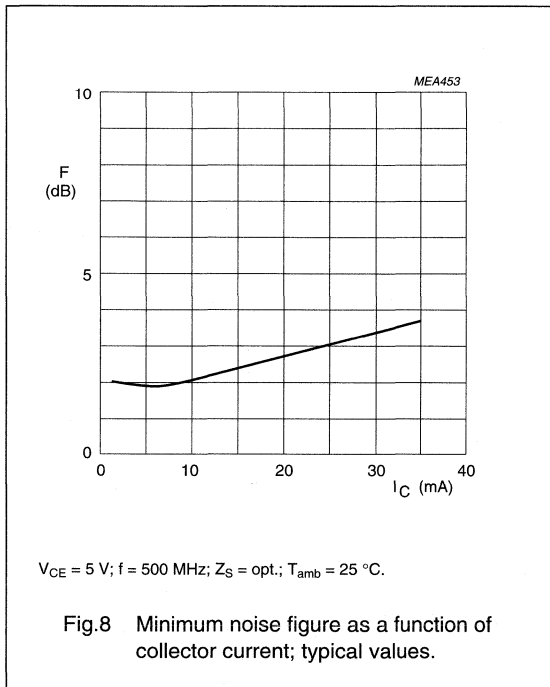
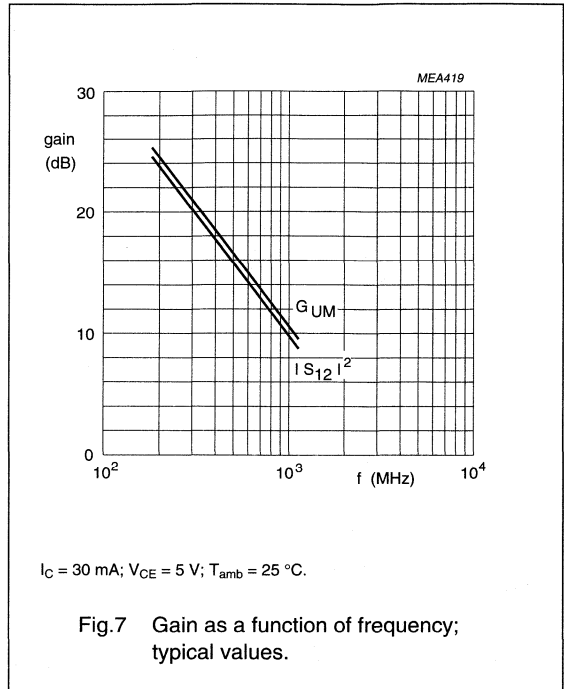
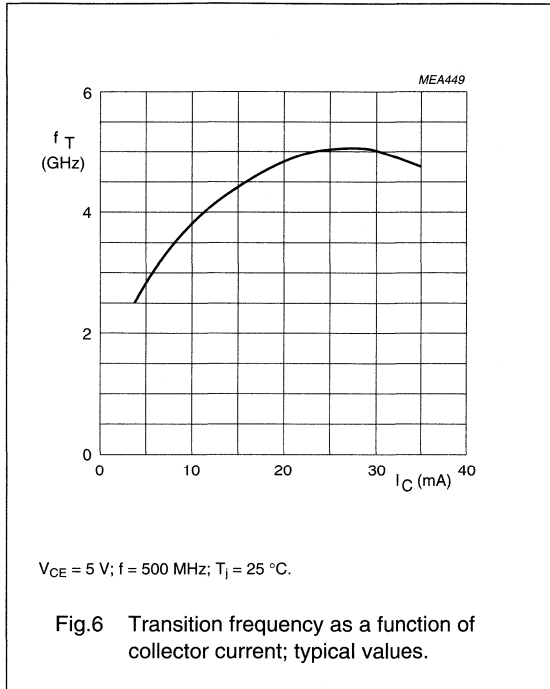
NPN 5 GHz wideband transistor

BFR93



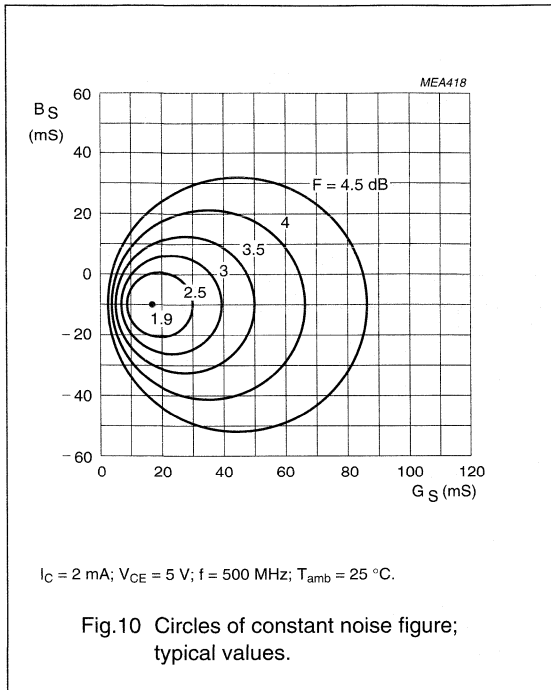
NPN 5 GHz wideband transistor

BFR93



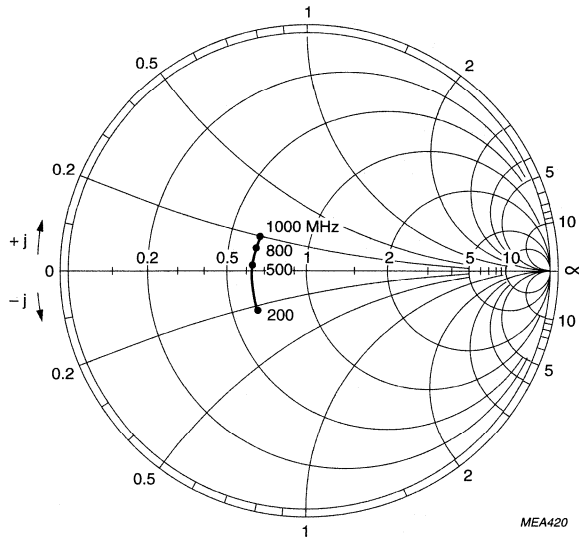
NPN 5 GHz wideband transistor

BFR93



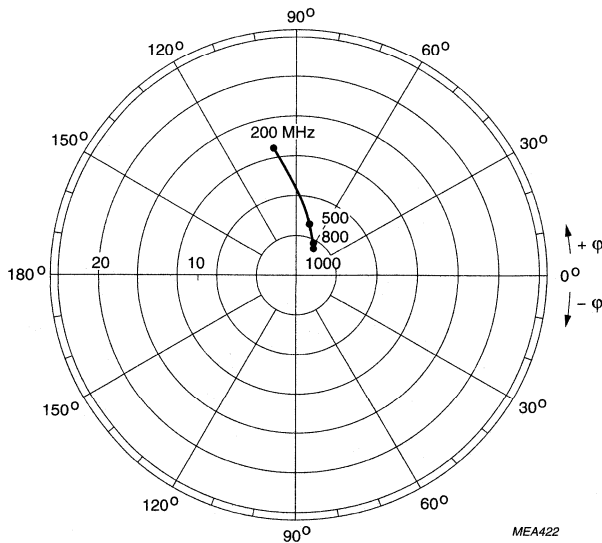
NPN 5 GHz wideband transistor

BFR93



$I_C = 30 \text{ mA}$; $V_{CE} = 5 \text{ V}$; $Z_0 = 50 \Omega$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.11 Common emitter input reflection coefficient (S_{11}); typical values.

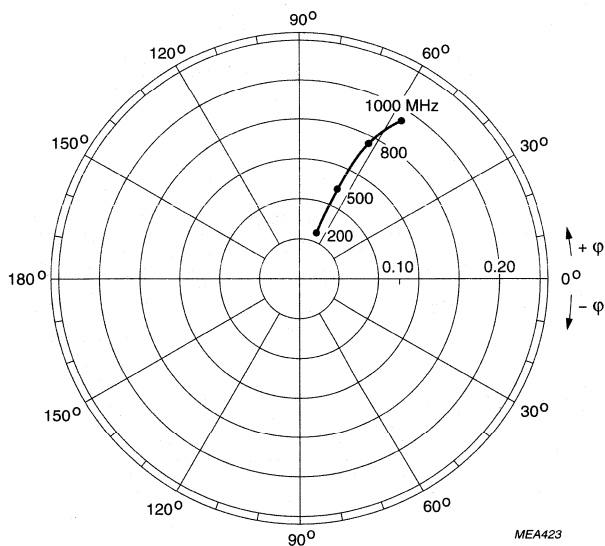


$I_C = 30 \text{ mA}$; $V_{CE} = 5 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.12 Common emitter forward transmission coefficient (S_{21}); typical values.

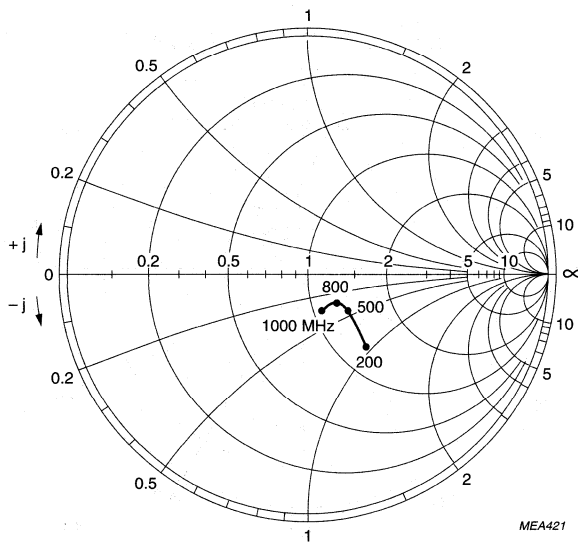
NPN 5 GHz wideband transistor

BFR93



$I_C = 30 \text{ mA}$; $V_{CE} = 5 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.13 Common emitter reverse transmission coefficient (S_{12}); typical values.



$I_C = 30 \text{ mA}$; $V_{CE} = 5 \text{ V}$; $Z_o = 50 \text{ } \Omega$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.14 Common emitter output reflection coefficient (S_{22}); typical values.

NPN 6 GHz wideband transistor

BFR93A

FEATURES

- High power gain
- Low noise figure
- Very low intermodulation distortion.

APPLICATIONS

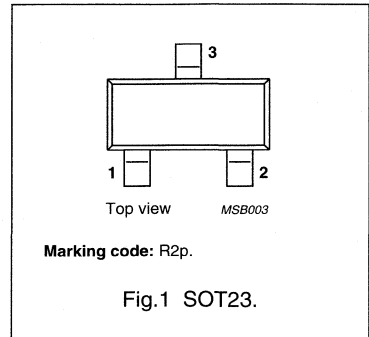
- RF wideband amplifiers and oscillators.

DESCRIPTION

NPN wideband transistor in a plastic SOT23 package.
PNP complement: BFT93.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 12 | V |
| I_C | collector current (DC) | | – | 35 | mA |
| P_{tot} | total power dissipation | $T_s \leq 95\text{ }^\circ\text{C}$ | – | 300 | mW |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$ | 0.6 | – | pF |
| f_T | transition frequency | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$ | 6 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 13 | – | dB |
| | | $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 7 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $\Gamma_s = \Gamma_{opt}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 1.9 | – | dB |
| V_O | output voltage | $d_{im} = -60\text{ dB}$; $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 75\text{ }\Omega$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f_p + f_q - f_r = 793.25\text{ MHz}$ | 425 | – | mV |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 12 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | collector current (DC) | | – | 35 | mA |
| P_{tot} | total power dissipation | $T_s \leq 95\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | +175 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 6 GHz wideband transistor

BFR93A

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|----------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | $T_s \leq 95\text{ °C}$; note 1 | 260 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

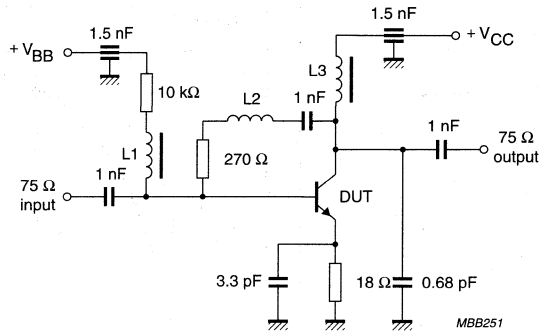
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 5\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$ | 40 | 90 | – | |
| C_c | collector capacitance | $I_E = I_e = 0$; $V_{CB} = 5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| C_e | emitter capacitance | $I_C = I_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.9 | – | pF |
| C_{re} | feedback capacitance | $I_C = I_c = 0$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 0.6 | – | pF |
| f_T | transition frequency | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$ | 4.5 | 6 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| | | $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 7 | – | dB |
| F | noise figure (note 2) | $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $\Gamma_s = \Gamma_{opt}$; $T_{amb} = 25\text{ °C}$ | – | 1.9 | – | dB |
| | | $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $\Gamma_s = \Gamma_{opt}$; $T_{amb} = 25\text{ °C}$ | – | 3 | – | dB |
| V_O | output voltage | notes 2 and 3 | – | 425 | – | mV |
| d_2 | second order intermodulation distortion | notes 2 and 4 | – | –50 | – | dB |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB.
- Measured on the same die in a SOT37 package (BFR91A).
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$;
 $V_p = V_O$ at $d_{im} = -60\text{ dB}$; $f_p = 795.25\text{ MHz}$;
 $V_q = V_O - 6\text{ dB}$ at $f_q = 803.25\text{ MHz}$;
 $V_r = V_O - 6\text{ dB}$ at $f_r = 805.25\text{ MHz}$;
 measured at $f_p + f_q - f_r = 793.25\text{ MHz}$.
- $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$;
 $V_p = 200\text{ mV}$ at $f_p = 250\text{ MHz}$;
 $V_q = 200\text{ mV}$ at $f_q = 560\text{ MHz}$;
 measured at $f_p + f_q = 810\text{ MHz}$.

NPN 6 GHz wideband transistor

BFR93A



L1 = L3 = 5 μH choke.
 L2 = 3 turns 0.4 mm copper wire; winding pitch 1 mm; internal diameter 3 mm.

Fig.2 Intermodulation distortion and second harmonic distortion MATV test circuit.

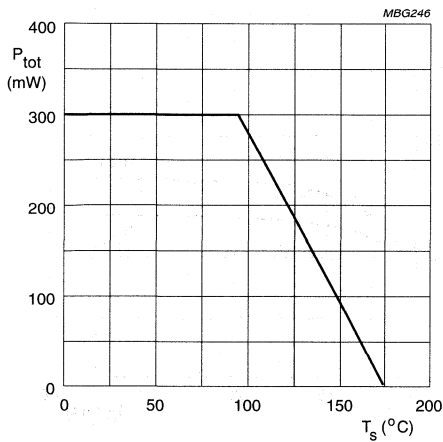
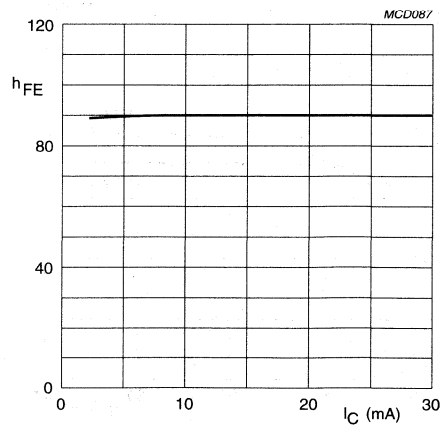


Fig.3 Power derating curve.

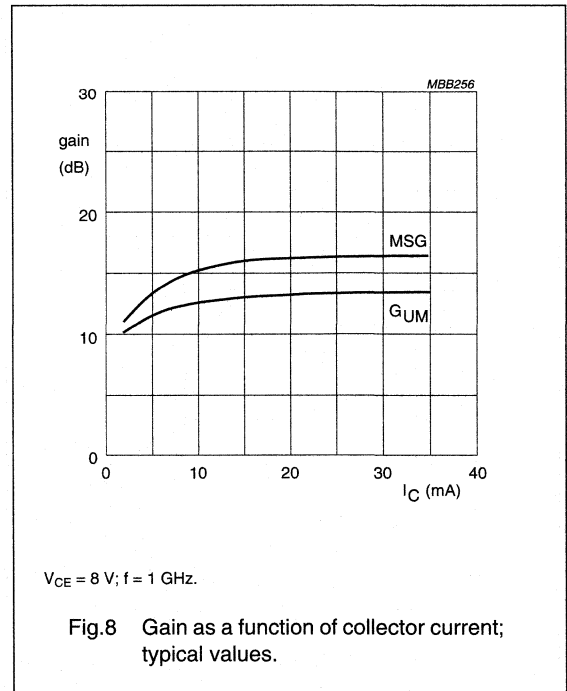
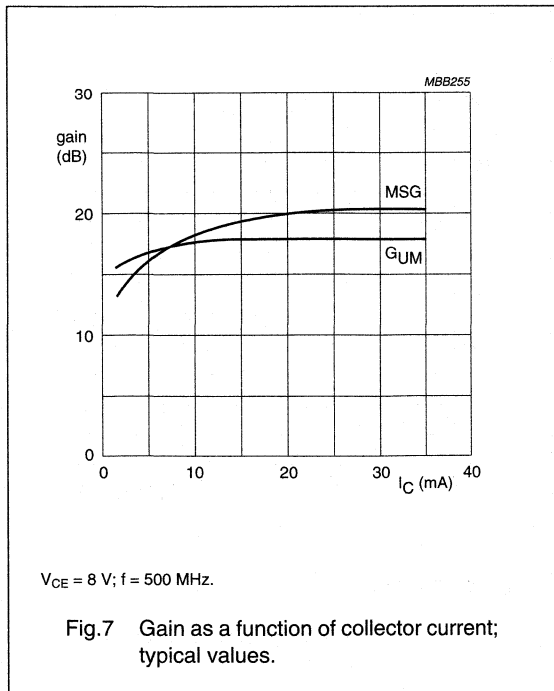
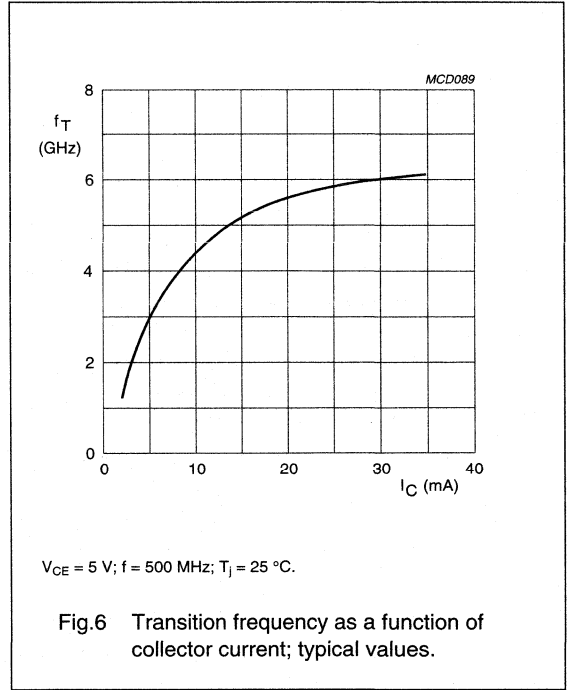
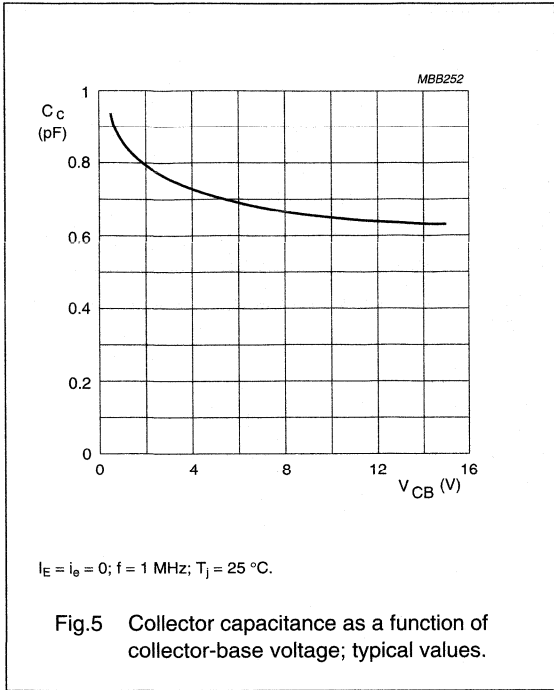


V_{CE} = 5 V; T_j = 25 °C.

Fig.4 DC current gain as a function of collector current.

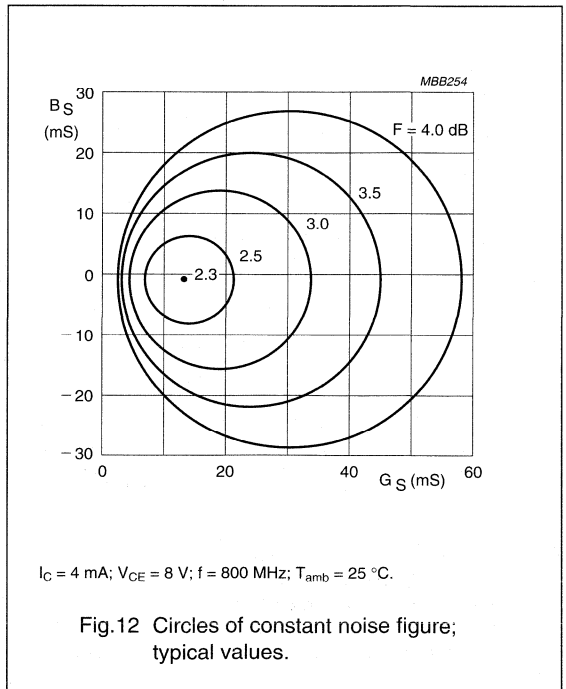
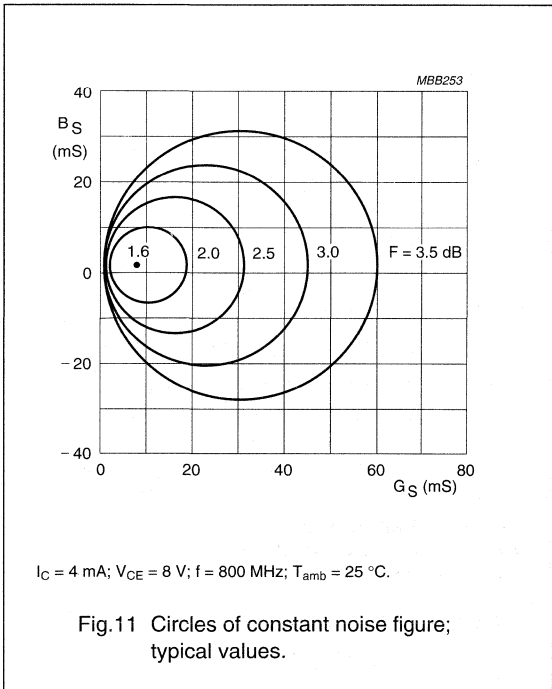
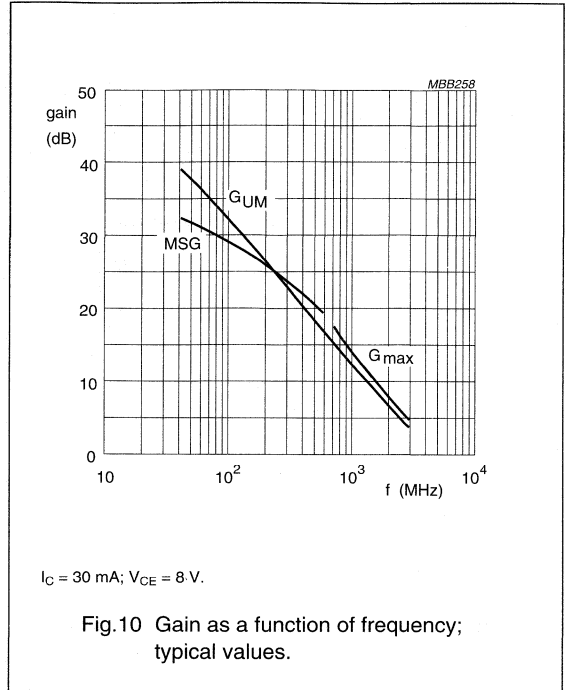
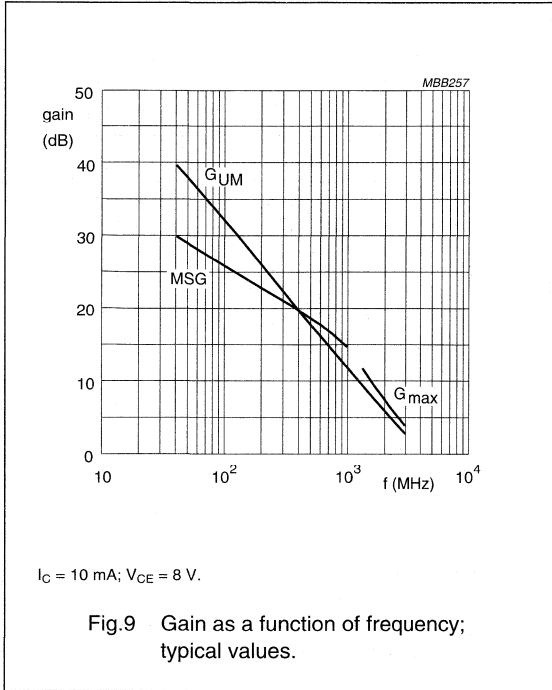
NPN 6 GHz wideband transistor

BFR93A



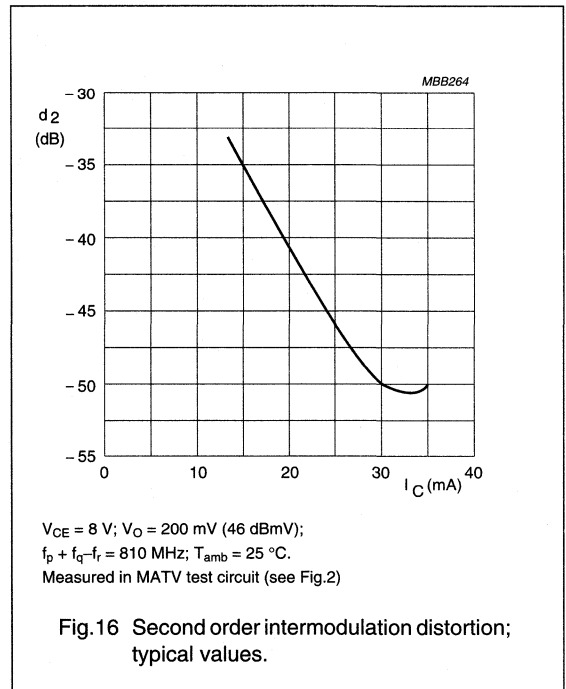
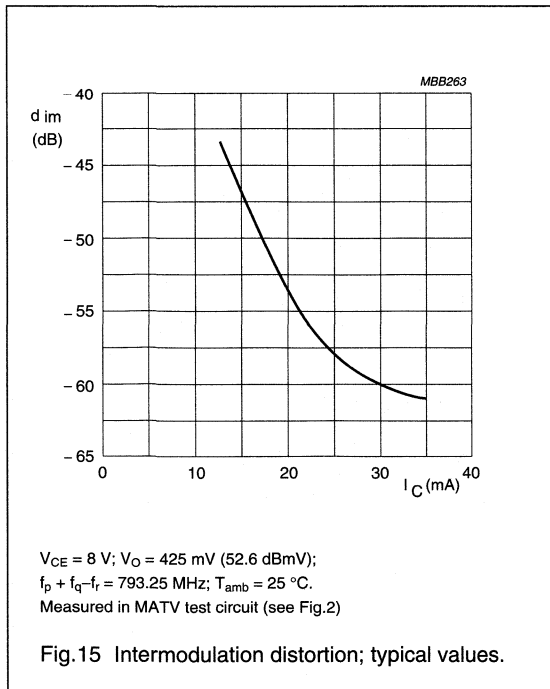
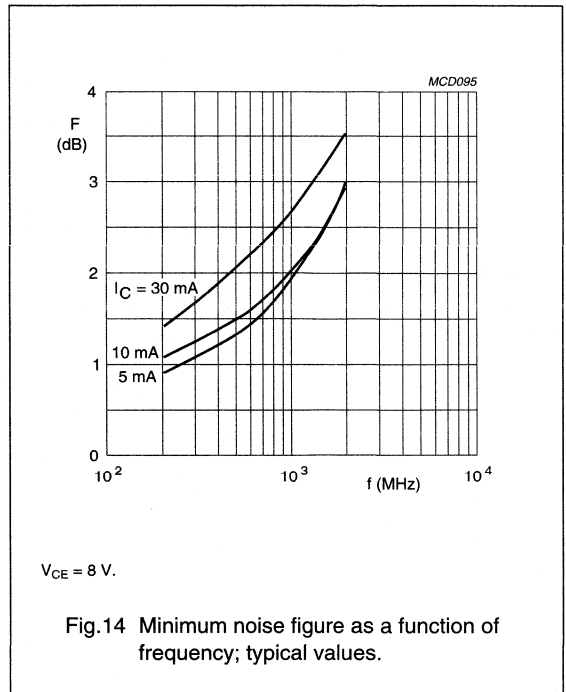
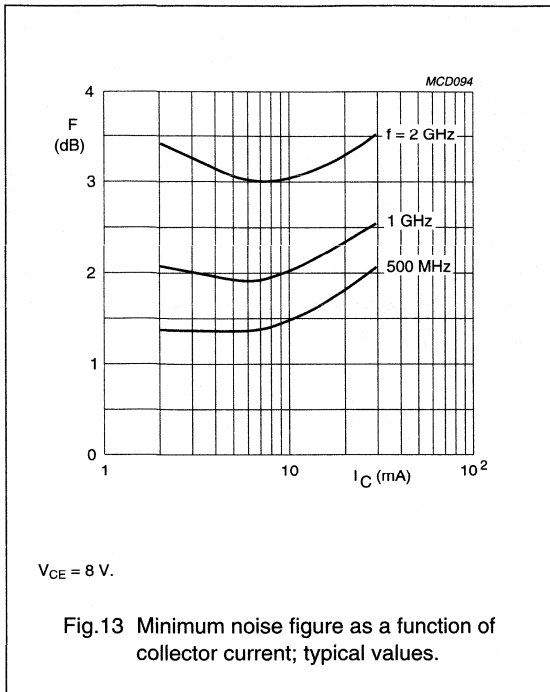
NPN 6 GHz wideband transistor

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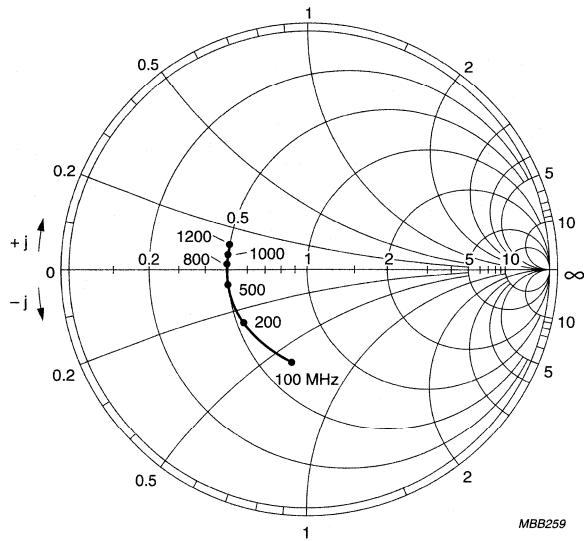
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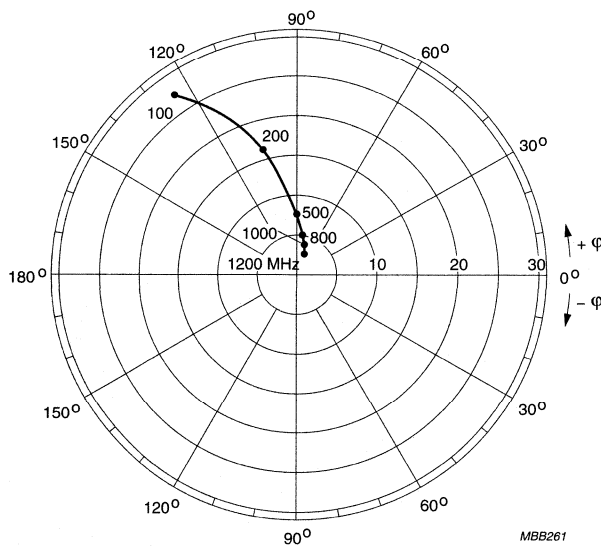
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$I_C = 30 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $Z_0 = 50 \Omega$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.17 Common emitter input reflection coefficient (S_{11}).

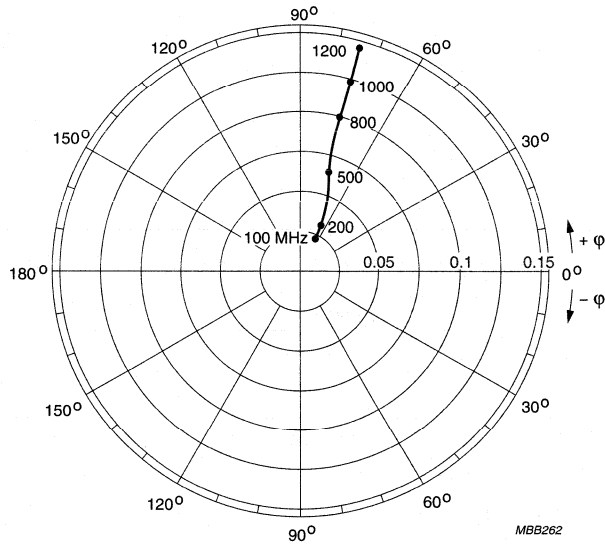


$I_C = 30 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.18 Common emitter forward transmission coefficient (S_{21}).

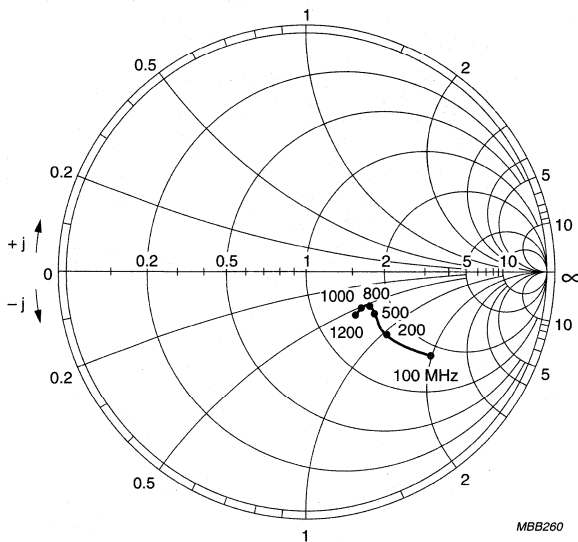
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$I_C = 30 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.19 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 30 \text{ mA}$; $V_{CE} = 8 \text{ V}$; $Z_o = 50 \text{ } \Omega$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.20 Common emitter output reflection coefficient (S_{22}).

NPN 5 GHz wideband transistor

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FEATURES

- High power gain
- Gold metallization ensures excellent reliability
- SOT323 (S-mini) package.

APPLICATIONS

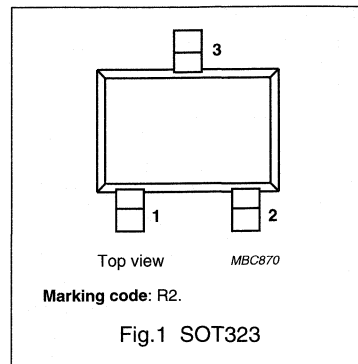
It is designed for use in RF amplifiers, mixers and oscillators with signal frequencies up to 1 GHz.

DESCRIPTION

Silicon NPN transistor encapsulated in a plastic SOT323 (S-mini) package. The BFR93AW uses the same crystal as the SOT23 version, BFR93A.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 12 | V |
| I_C | collector current (DC) | | – | – | 35 | mA |
| P_{tot} | total power dissipation | up to $T_s = 93\text{ °C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$ | 40 | 90 | – | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 0.6 | – | pF |
| f_T | transition frequency | $I_C = 30\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$ | 4 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| | | $I_C = 30\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 8 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $\Gamma_s = \Gamma_{opt}$ | – | 1.5 | – | dB |
| T_j | junction temperature | | – | – | 150 | °C |

Note

1. T_s is the temperature at the soldering point of the collector pin.

NPN 5 GHz wideband transistor

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LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

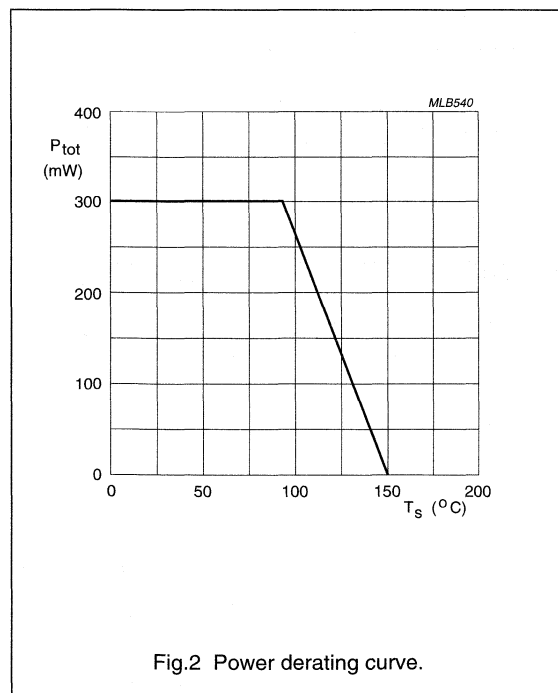
| SYMBOL | PARAMETER | CONDITION | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | — | 15 | V |
| V_{CEO} | collector-emitter voltage | open base | — | 12 | V |
| V_{EBO} | emitter-base voltage | open collector | — | 2 | V |
| I_C | collector current (DC) | | — | 35 | mA |
| P_{tot} | total power dissipation | up to $T_s = 93\text{ }^\circ\text{C}$; see Fig.2; note 1 | — | 300 | mW |
| T_{stg} | storage temperature | | -65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | — | 150 | $^\circ\text{C}$ |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITION | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 93\text{ }^\circ\text{C}$; note 1 | 190 | K/W |

Note to the Limiting values and Thermal characteristics

- T_s is the temperature at the soldering point of the collector pin.



NPN 5 GHz wideband transistor

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CHARACTERISTICS

$T_j = 25\text{ °C}$ (unless otherwise specified).

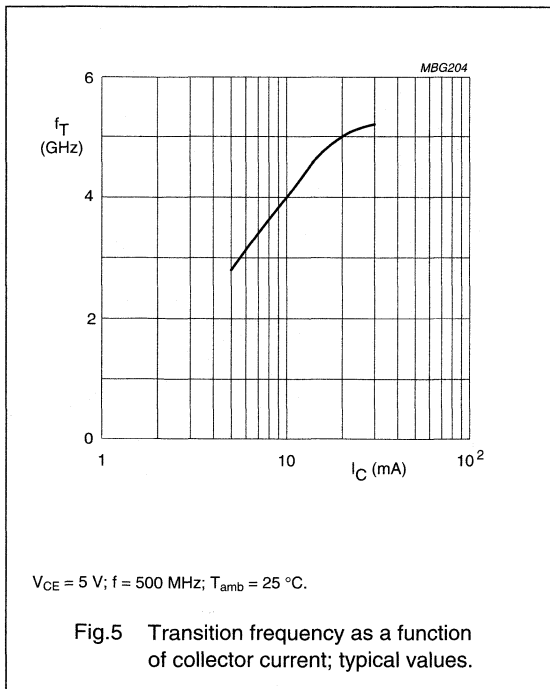
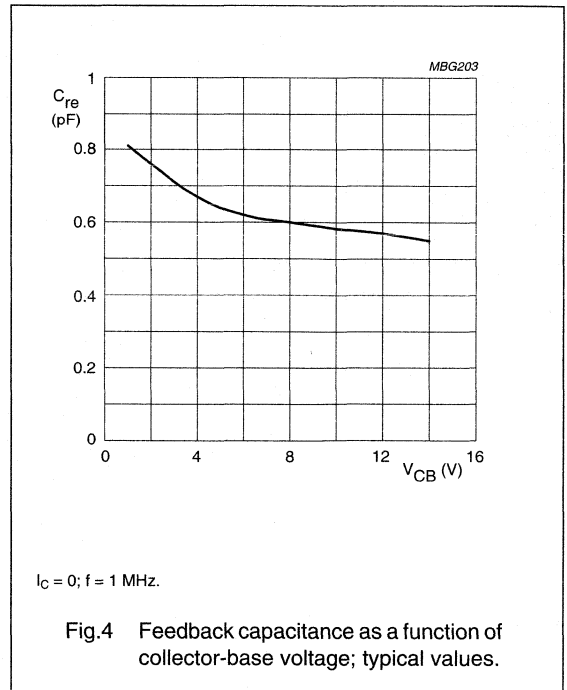
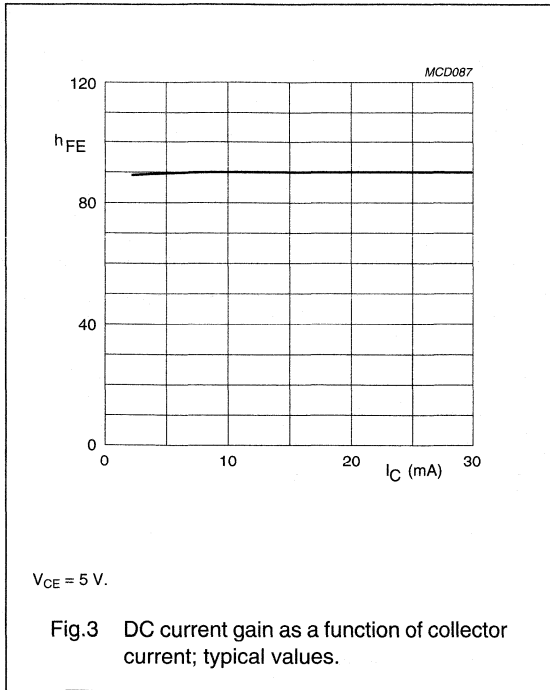
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------------------|---|------|------|------|------|
| I_{CBO} | collector leakage current | $I_E = 0; V_{CB} = 5\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 30\text{ mA}; V_{CE} = 5\text{ V}$ | 40 | 90 | – | |
| C_c | collector capacitance | $I_E = I_e = 0; V_{CB} = 5\text{ V}; f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| C_e | emitter capacitance | $I_C = I_c = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 2.3 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CE} = 5\text{ V}; f = 1\text{ MHz}$ | – | 0.6 | – | pF |
| f_T | transition frequency | $I_C = 30\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}$ | 4 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = 30\text{ mA}; V_{CE} = 8\text{ V}; f = 1\text{ GHz}; T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| | | $I_C = 30\text{ mA}; V_{CE} = 8\text{ V}; f = 2\text{ GHz}; T_{amb} = 25\text{ °C}$ | – | 8 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}; V_{CE} = 8\text{ V}; f = 1\text{ GHz}; \Gamma_s = \Gamma_{opt}$ | – | 1.5 | – | dB |
| | | $I_C = 5\text{ mA}; V_{CE} = 8\text{ V}; f = 2\text{ GHz}; \Gamma_s = \Gamma_{opt}$ | – | 2.1 | – | dB |

Note

1. G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero and $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

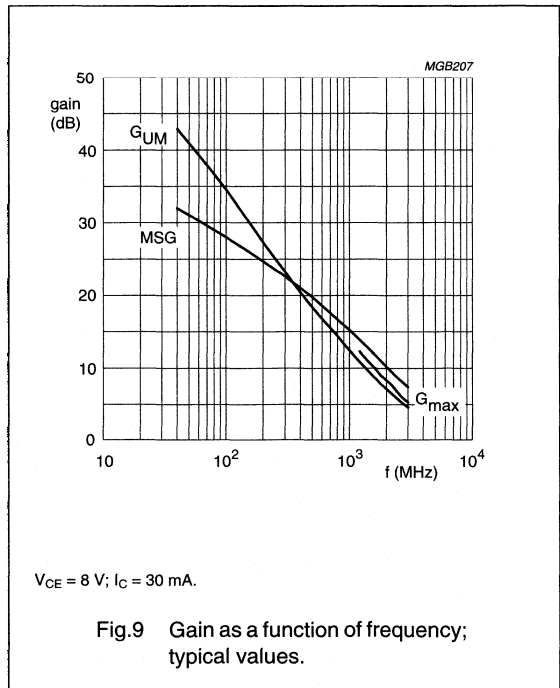
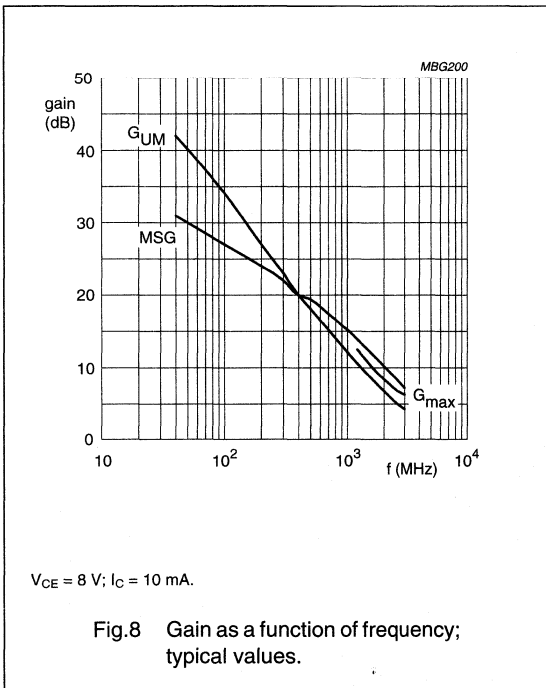
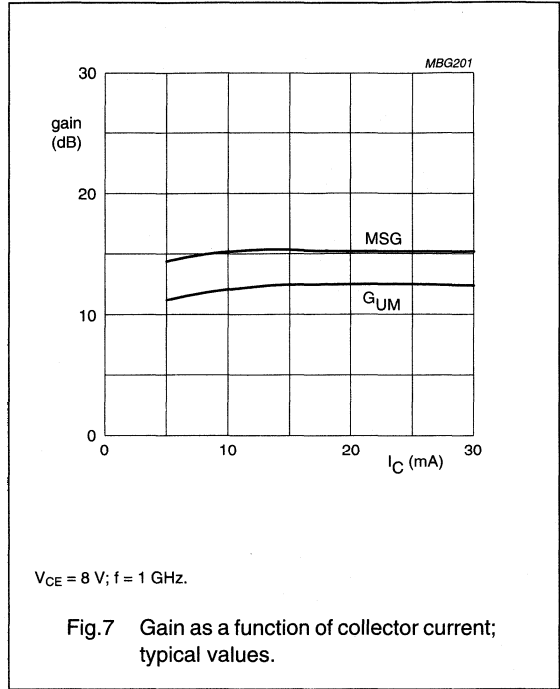
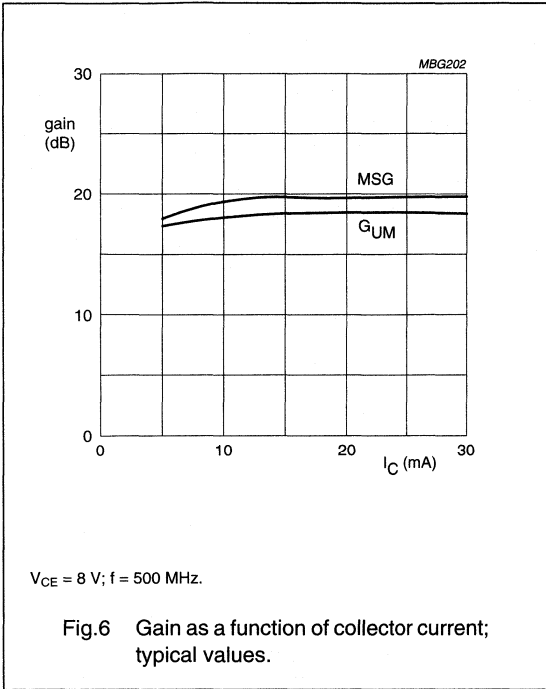
NPN 5 GHz wideband transistor

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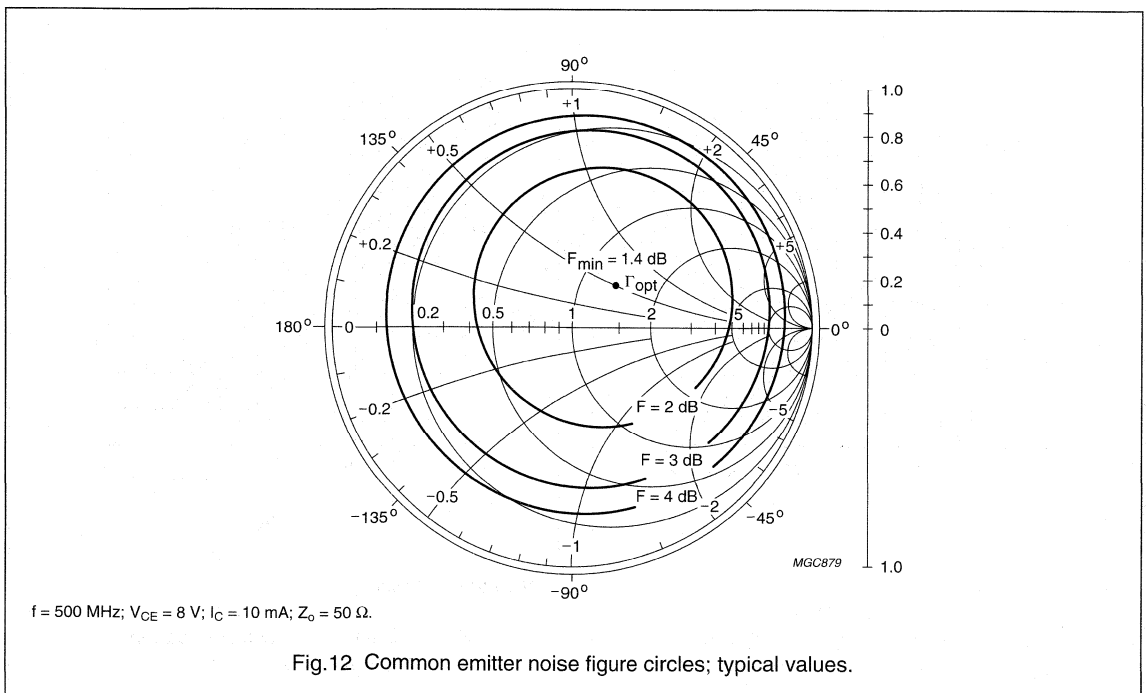
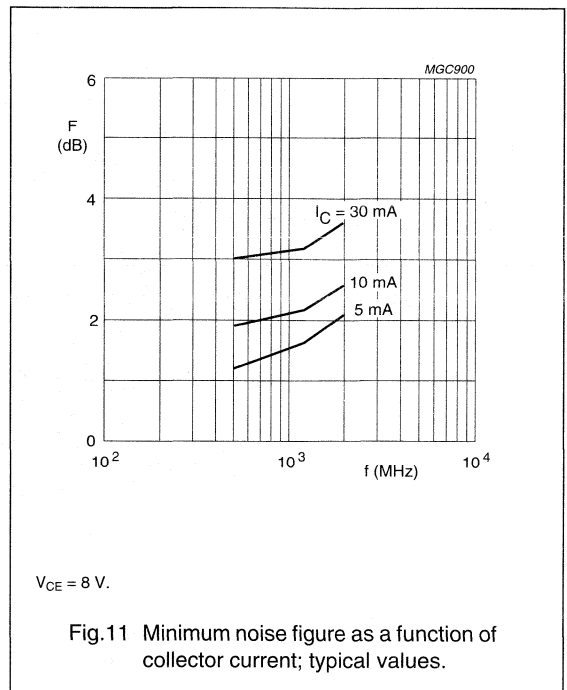
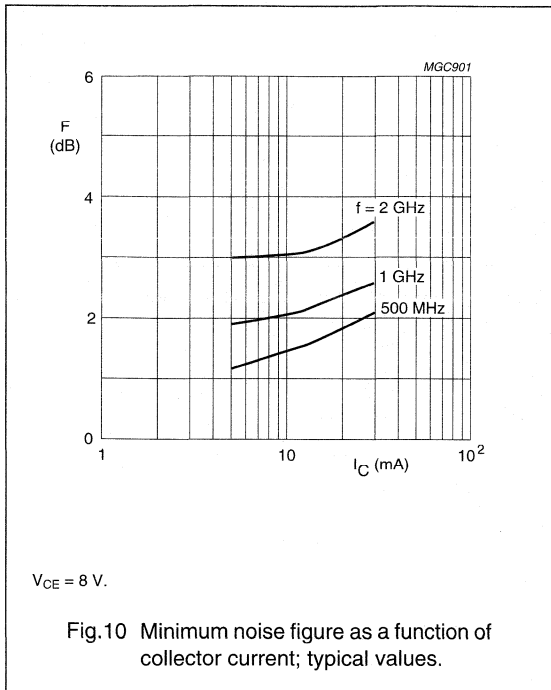
NPN 5 GHz wideband transistor

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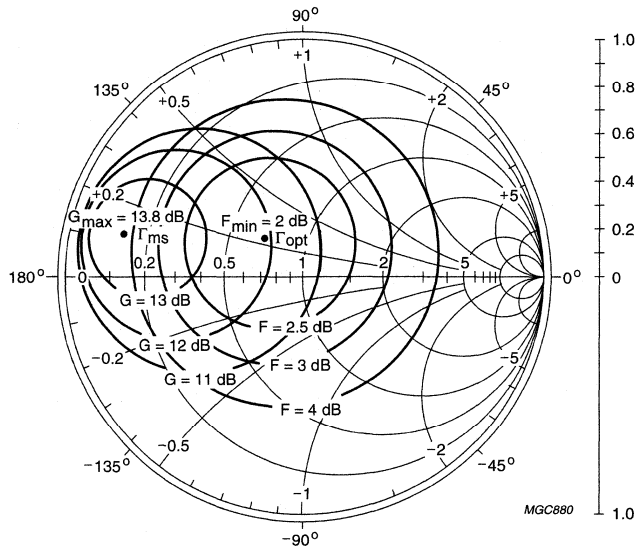
NPN 5 GHz wideband transistor

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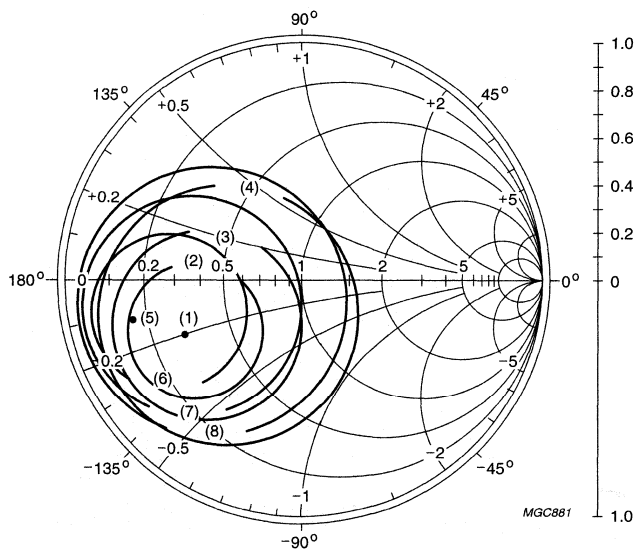
NPN 5 GHz wideband transistor

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$f = 1 \text{ GHz}$; $V_{CE} = 8 \text{ V}$; $I_C = 10 \text{ mA}$; $Z_o = 50 \Omega$.

Fig.13 Common emitter noise figure circles; typical values.

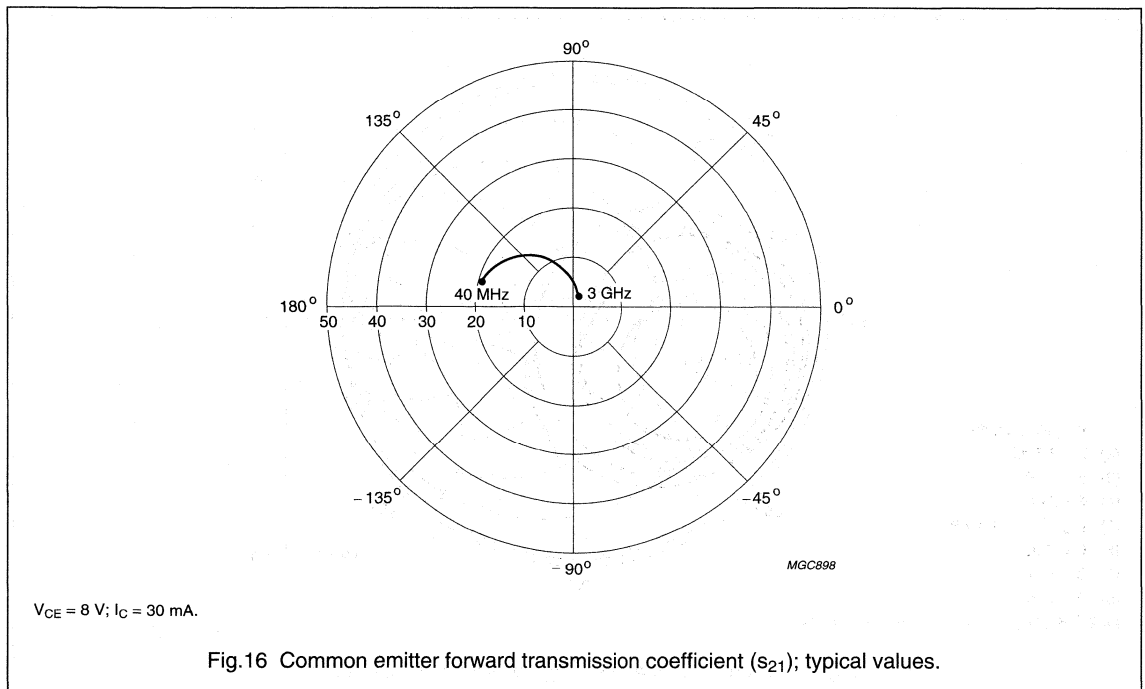
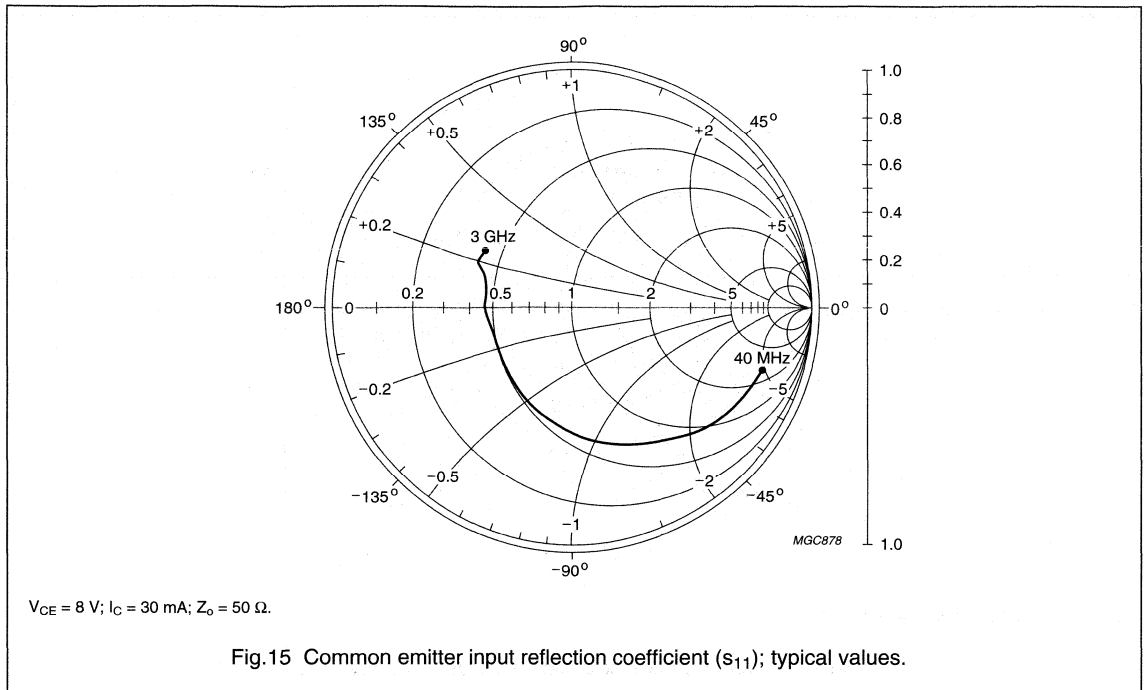


$f = 2 \text{ GHz}$; $V_{CE} = 8 \text{ V}$; $I_C = 10 \text{ mA}$; $Z_o = 50 \Omega$.

Fig.14 Common emitter noise figure circles; typical values.

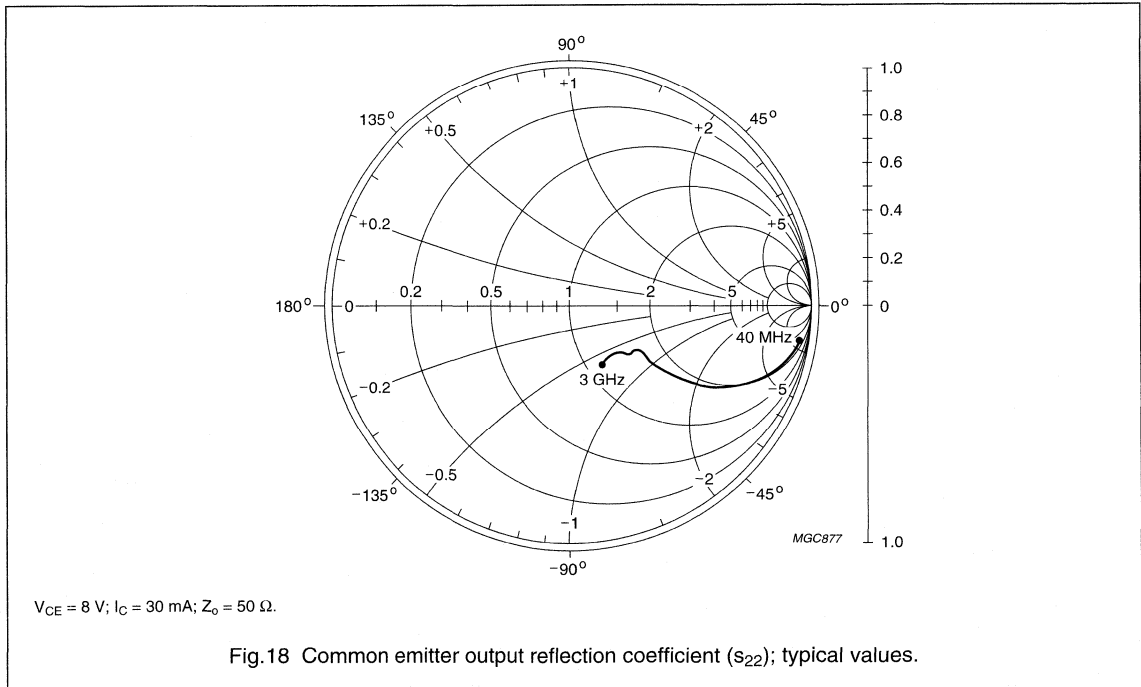
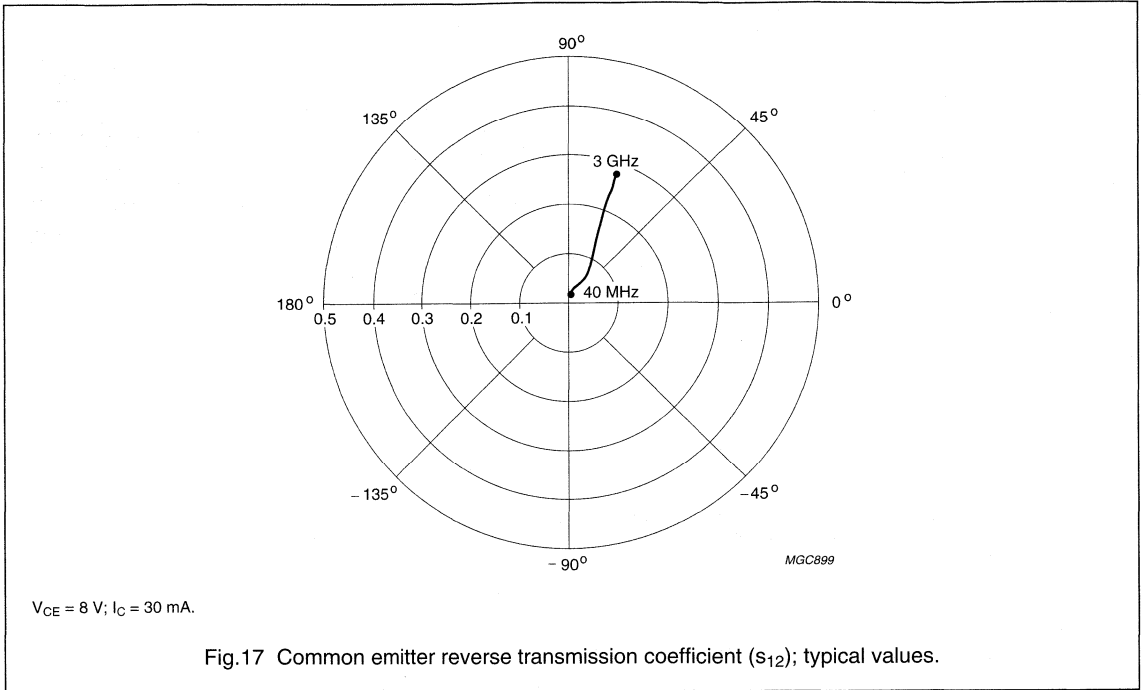
NPN 5 GHz wideband transistor

BFR93AW



NPN 5 GHz wideband transistor

BFR93AW



NPN 3.5 GHz wideband transistor

BFR94A

DESCRIPTION

NPN resistance-stabilized transistor in a SOT122E capstan envelope.

It features extremely low cross modulation, intermodulation and second order intermodulation distortion. Due to its high transition frequency, it has a high power gain, in conjunction with good wideband properties, and low noise up to high frequencies.

It is primarily intended for CATV and MATV applications.

The BFR94A is a replacement for the BFR94. The SOT122E footprint is similar to that of the SOT48, used for the BFR94.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | collector |
| 2 | emitter |
| 3 | base |
| 4 | emitter |

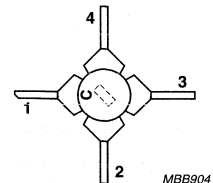


Fig.1 SOT122E.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 30 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| I_C | DC collector current | | – | 150 | mA |
| P_{tot} | total power dissipation | up to $T_c = 145\text{ °C}$; $f > 1\text{ MHz}$ | – | 3.5 | W |
| f_T | transition frequency | $I_C = 90\text{ mA}$; $V_{CE} = 20\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ °C}$ | 3.5 | – | GHz |
| F | noise figure | $I_C = 90\text{ mA}$; $V_{CE} = 20\text{ V}$; $f = 200\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 8 | 10 | dB |
| d_{im} | intermodulation distortion | $I_C = 90\text{ mA}$; $V_{CE} = 20\text{ V}$; $V_o = 60\text{ dBmV}$; $f_{(p+q-r)} = 194.25\text{ MHz}$ | –63 | – | dB |
| d_2 | second order intermodulation distortion | $I_C = 90\text{ mA}$; $V_{CE} = 20\text{ V}$; $V_o = 48\text{ dBmV}$; $f_p + f_q = 210\text{ MHz}$ | – | –56 | dB |

WARNING

Product and environmental safety - toxic materials

This product contains beryllium oxide. The product is entirely safe provided that the BeO disc is not damaged. All persons who handle, use or dispose of this product should be aware of its nature and of the necessary safety precautions. After use, dispose of as chemical or special waste according to the regulations applying at the location of the user. It must never be thrown out with the general or domestic waste.

NPN 3.5 GHz wideband transistor

BFR94A

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CB0} | collector-base voltage | open emitter | – | 30 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| V_{CER} | collector-emitter voltage | $R_{BE} = 100 \Omega$ | – | 35 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| I_C | DC collector current | | – | 150 | mA |
| I_{CM} | peak collector current | $f > 1 \text{ MHz}$ | – | 300 | mA |
| P_{tot} | total power dissipation | up to $T_C = 145 \text{ }^\circ\text{C}$; $f > 1 \text{ MHz}$ | – | 3.5 | W |
| T_{stg} | storage temperature | | –65 | 200 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 200 | $^\circ\text{C}$ |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|--------------|--|--------------------|
| $R_{th j-c}$ | thermal resistance from junction to case | 15 K/W |

NPN 3.5 GHz wideband transistor

BFR94A

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|--|------|------|------|---------------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 20\text{ V}$ | – | – | 50 | μA |
| h_{FE} | DC current gain | $I_C = 50\text{ mA}; V_{CE} = 20\text{ V}$ | 30 | – | – | |
| | | $I_C = 150\text{ mA}; V_{CE} = 20\text{ V}$ | 30 | – | – | |
| f_T | transition frequency | $I_C = 90\text{ mA}; V_{CE} = 20\text{ V}; f = 500\text{ MHz}$ | – | 3.5 | – | GHz |
| | | $I_C = 150\text{ mA}; V_{CE} = 20\text{ V}; f = 500\text{ MHz}$ | – | 3.5 | – | GHz |
| C_c | collector capacitance | $I_E = I_B = 0; V_{CB} = 20\text{ V}; f = 1\text{ MHz}$ | – | 3.5 | – | pF |
| C_e | emitter capacitance | $I_C = I_C = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 12 | – | pF |
| C_{re} | feedback capacitance | $I_C = 10\text{ mA}; V_{CE} = 20\text{ V}; f = 1\text{ MHz}$ | – | 1.3 | – | pF |
| C_{cs} | collector-stud capacitance | $f = 1\text{ MHz}$ | – | 2 | – | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 90\text{ mA}; V_{CE} = 20\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 13.5 | – | dB |
| F | noise figure | $I_C = 90\text{ mA}; V_{CE} = 20\text{ V}; f = 200\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 8 | 10 | dB |
| | | $I_C = 90\text{ mA}; V_{CE} = 20\text{ V}; f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 5 | – | dB |
| d_{im} | intermodulation distortion | note 2 | – | –63 | – | dB |
| d_2 | second order intermodulation distortion | note 3 | – | – | –56 | dB |
| V_o | output voltage | see Fig.2 and note 4 | – | 700 | – | mV |

Notes

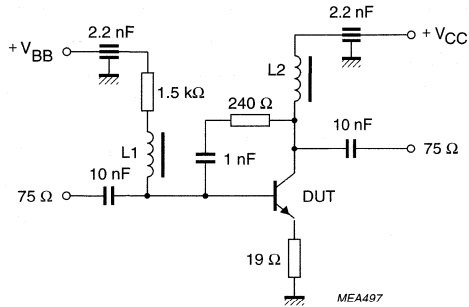
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

2. $I_C = 90\text{ mA}; V_{CE} = 20\text{ V}; R_L = 75\ \Omega;$
 $V_p = V_o = 60\text{ dBmV}$ at $f_p = 196.25\text{ MHz};$
 $V_q = V_o - 6\text{ dB}$ at $f_q = 203.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}$ at $f_r = 205.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 194.25\text{ MHz}.$
3. $I_C = 90\text{ mA}; V_{CE} = 20\text{ V};$
 $f_p = 66\text{ MHz}; f_q = 144\text{ MHz}; f_p + f_q = 210\text{ MHz}; V_o = 48\text{ dBmV}.$
4. $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 90\text{ mA}; V_{CE} = 20\text{ V}; R_L = 75\ \Omega; T_{amb} = 25\text{ }^\circ\text{C};$
 $V_p = V_o$ at $d_{im} = -60\text{ dB}; f_p = 495.25\text{ MHz};$
 $V_q = V_o - 6\text{ dB}; f_q = 503.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_r = 505.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 493.25\text{ MHz}.$

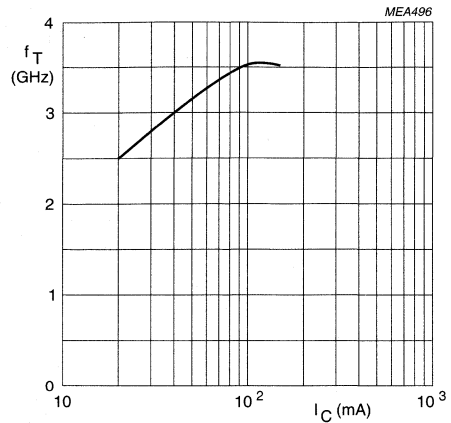
NPN 3.5 GHz wideband transistor

BFR94A



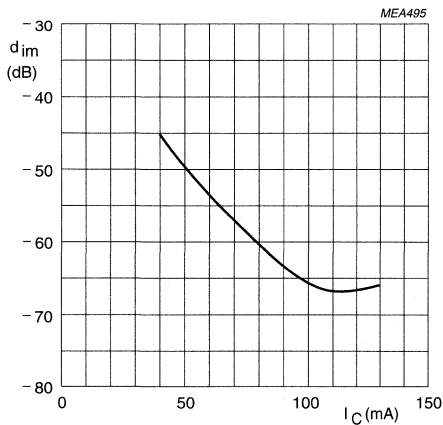
L1 = L2 = 5 μH Ferroxcube choke, catalogue number 3122 108 20153.

Fig.2 Intermodulation distortion MATV test circuit.



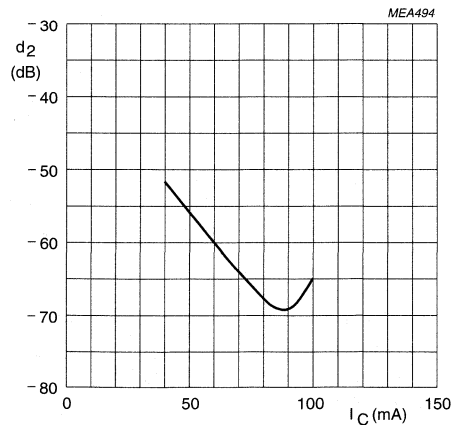
V_{CE} = 20 V; f = 500 MHz; T_j = 25 °C.

Fig.3 Transition frequency as a function of collector current.



Measured in CATV test circuit.
V_{CE} = 20 V; V_o = 60 dBmV;
f_{(p+q-r)}} = 194. 25 MHz.

Fig.4 Intermodulation distortion as a function of collector current.

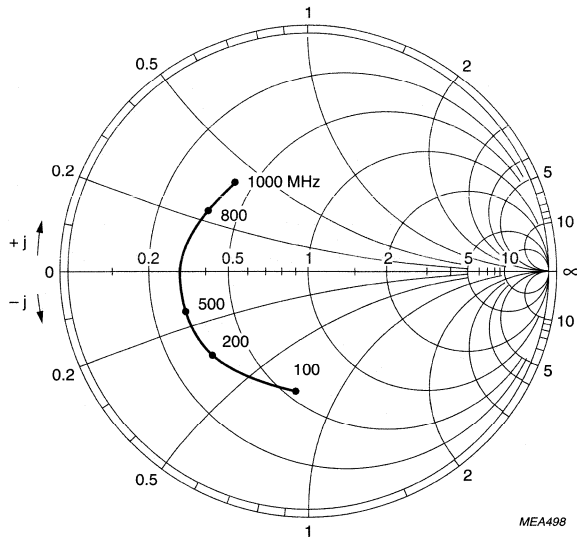


Measured in CATV test circuit.
V_{CE} = 20 V; V_o = 48 dBmV; f = 210 MHz.

Fig.5 Second order intermodulation distortion as a function of collector current.

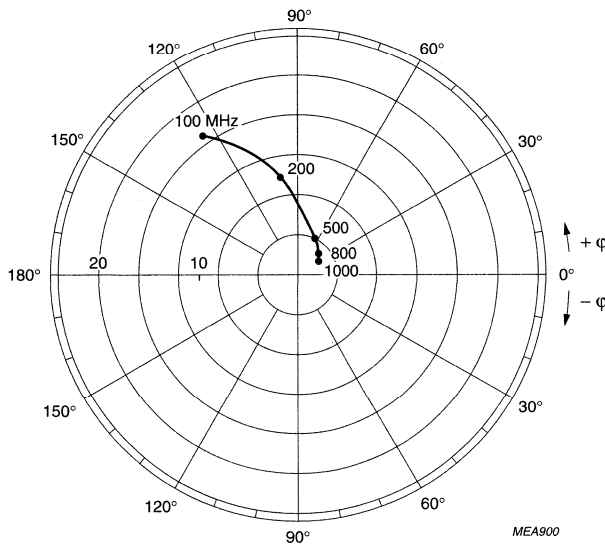
NPN 3.5 GHz wideband transistor

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$I_C = 90 \text{ mA}$; $V_{CE} = 20 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_o = 50 \text{ } \Omega$.

Fig.6 Common emitter input reflection coefficient (S_{11}).

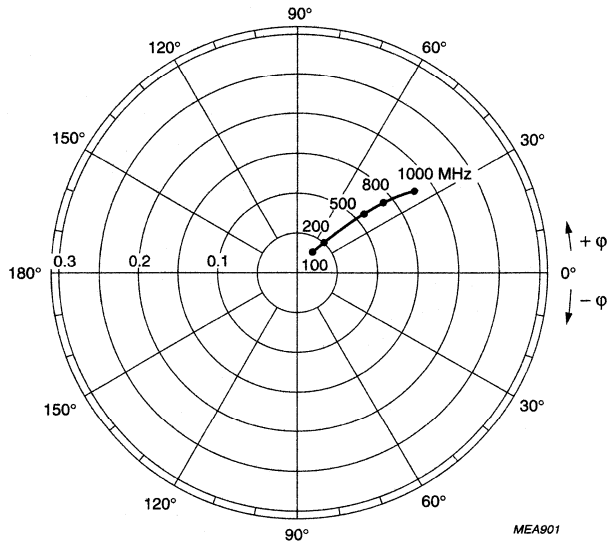


$I_C = 90 \text{ mA}$; $V_{CE} = 20 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.7 Common emitter forward transmission coefficient (S_{21}).

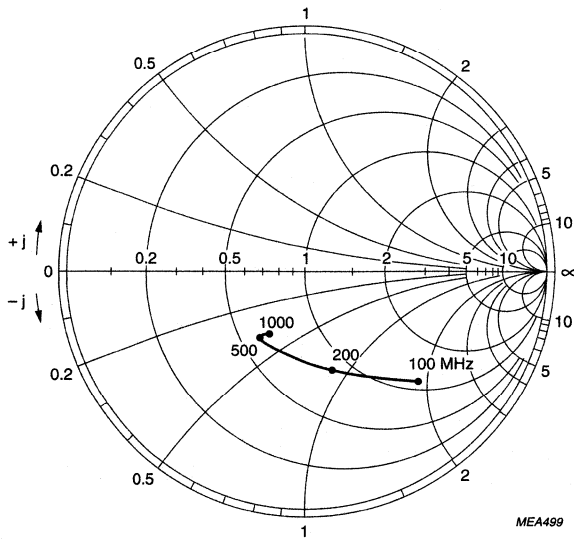
NPN 3.5 GHz wideband transistor

BFR94A



$I_C = 90 \text{ mA}$; $V_{CE} = 20 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.8 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 90 \text{ mA}$; $V_{CE} = 20 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_o = 50 \text{ } \Omega$.

Fig.9 Common emitter output reflection coefficient (S_{22}).

NPN 5 GHz wideband transistor

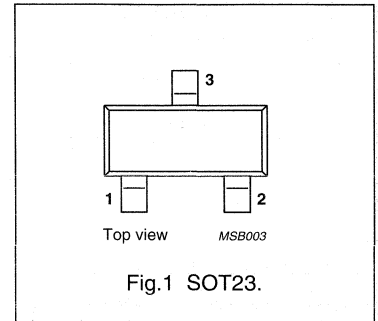
BFR106

DESCRIPTION

NPN silicon planar epitaxial transistor in a plastic SOT23 envelope. It is primarily intended for low noise, general RF applications.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: R7p | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | DC collector current | | – | – | 100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ °C}$; note 1 | – | – | 500 | mW |
| h_{FE} | DC current gain | $I_C = 50\text{ mA}$; $V_{CE} = 9\text{ V}$; $T_{amb} = 25\text{ °C}$ | 25 | 80 | – | |
| f_T | transition frequency | $I_C = 50\text{ mA}$; $V_{CE} = 9\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 30\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 11.5 | – | dB |
| V_o | output voltage | $I_C = 50\text{ mA}$; $V_{CE} = 9\text{ V}$; $R_L = 75\text{ }\Omega$; $T_{amb} = 25\text{ °C}$; $d_{im} = -60\text{ dB}$; $f_{(p+q-r)} = 793.25\text{ MHz}$ | – | 350 | – | mV |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| I_C | DC collector current | | – | 100 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ °C}$; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 5 GHz wideband transistor

BFR106

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|-------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 70\text{ °C}$; note 1 | 210 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 100 | nA |
| h_{FE} | DC current gain | $I_C = 50\text{ mA}$; $V_{CE} = 9\text{ V}$ | 25 | 80 | – | |
| f_T | transition frequency | $I_C = 50\text{ mA}$; $V_{CE} = 9\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 5 | – | GHz |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 1.5 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 4.5 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 1.2 | – | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 30\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 11.5 | – | dB |
| F | noise figure | $I_C = 30\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 3.5 | – | dB |
| d_2 | second order intermodulation distortion | note 2 | – | –50 | – | dB |
| V_o | output voltage | note 3 | – | 350 | – | mV |

Notes

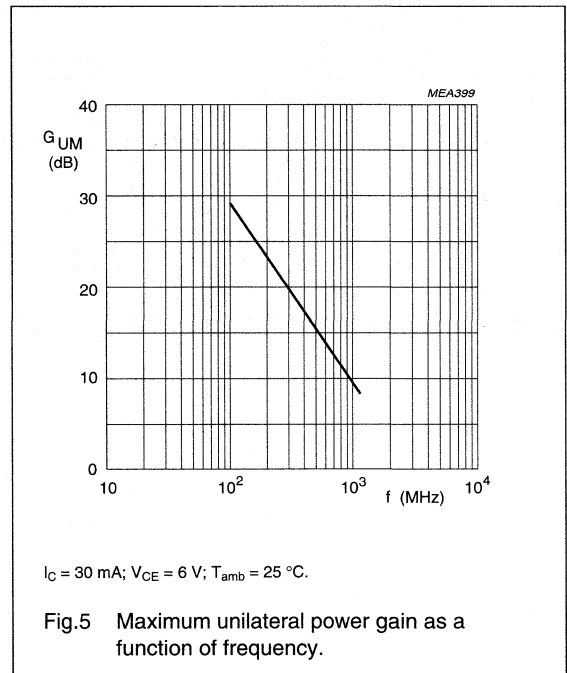
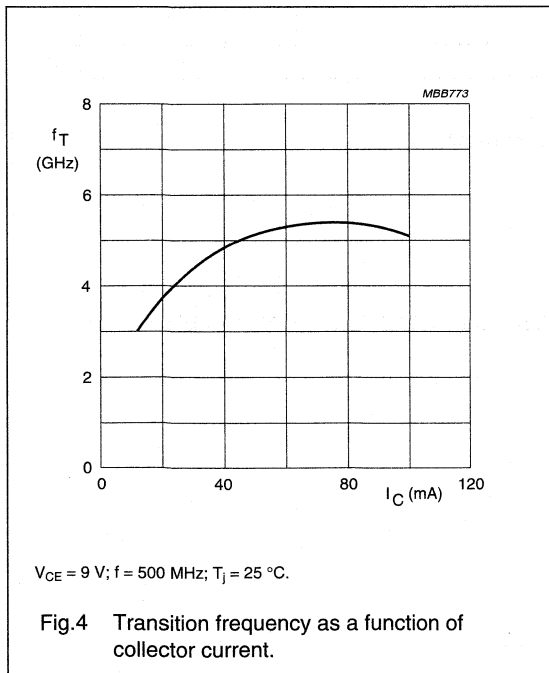
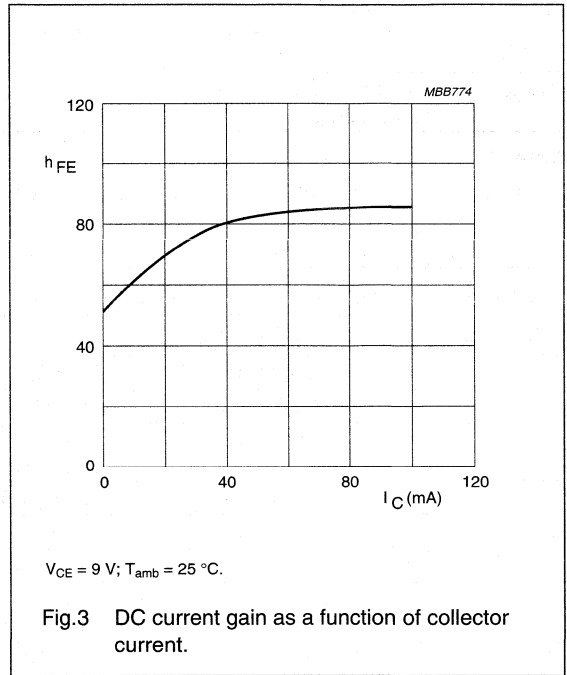
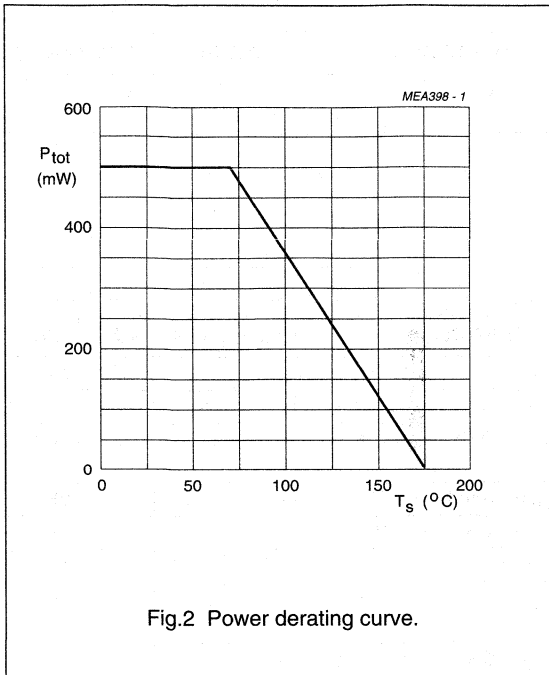
- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

- $I_C = 30\text{ mA}$; $V_{CE} = 6\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$;
 $f_{(p+q)} = 810\text{ MHz}$; $V_o = 100\text{ mV}$.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 50\text{ mA}$; $V_{CE} = 9\text{ V}$; $R_L = 75\ \Omega$; $T_{amb} = 25\text{ °C}$; $f_{(p+q-r)} = 793.25\text{ MHz}$.

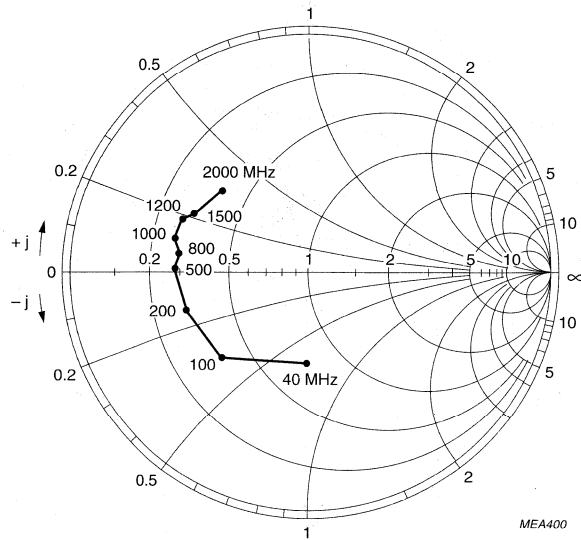
NPN 5 GHz wideband transistor

BFR106



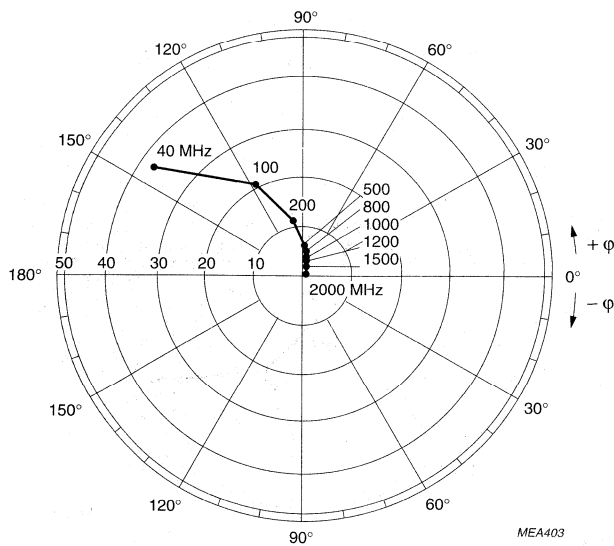
NPN 5 GHz wideband transistor

Common emitter amplifier BFR106



$I_C = 30 \text{ mA}$; $V_{CE} = 6 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_o = 50 \text{ } \Omega$.

Fig.6 Common emitter input reflection coefficient (S_{11}).

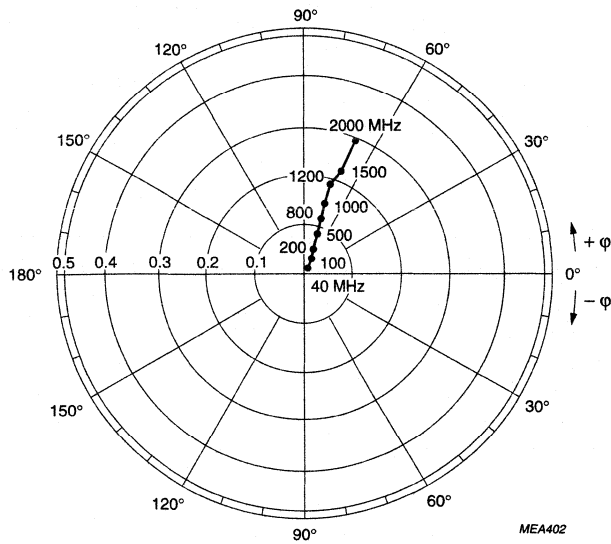


$I_C = 30 \text{ mA}$; $V_{CE} = 6 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.7 Common emitter forward transmission coefficient (S_{21}).

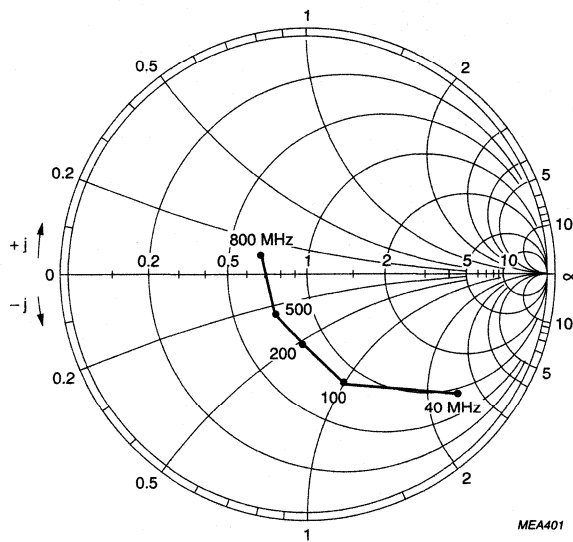
NPN 5 GHz wideband transistor

BFR106



$I_C = 30 \text{ mA}$; $V_{CE} = 6 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.8 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 30 \text{ mA}$; $V_{CE} = 6 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_o = 50 \text{ } \Omega$.

Fig.9 Common emitter output reflection coefficient (S_{22}).

NPN 9 GHz wideband transistor

BFR505

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: N30 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |

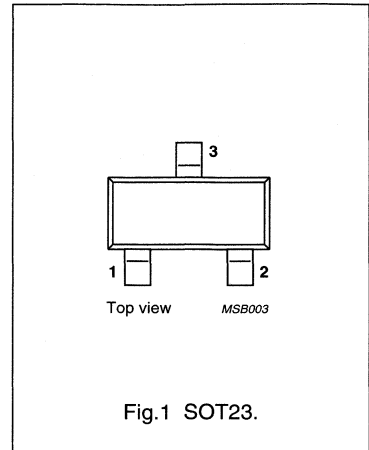


Fig.1 SOT23.

DESCRIPTION

The BFR505 is an npn silicon planar epitaxial transistor, intended for applications in the RF frontend in wideband applications in the GHz range, such as analog and digital cellular telephones, cordless telephones (CT1, CT2, DECT, etc.), radar detectors, pagers and satellite TV tuners (SATV).

The transistor is encapsulated in a plastic SOT23 envelope.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | DC collector current | | – | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ }^\circ\text{C}$; note 1 | – | – | 150 | mW |
| h_{FE} | DC current gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $I_C = i_c = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.3 | – | pF |
| f_T | transition frequency | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 17 | – | dB |
| | | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 10 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | 13 | 14 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 1.25\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 1.2 | 1.7 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 1.25\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 1.9 | – | dB |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFR505

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | | – | 2.5 | V |
| I_C | DC collector current | continuous | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 135\text{ °C}$; note 1 | – | 150 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 260 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFR505

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|--|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 6\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 5\text{ mA}; V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $I_C = I_e = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| C_c | collector capacitance | $I_E = I_e = 0; V_{CB} = 6\text{ V}; f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 6\text{ V}; f = 1\text{ MHz}$ | – | 0.3 | – | pF |
| f_T | transition frequency | $I_C = 5\text{ mA}; V_{CE} = 6\text{ V}; f = 1\text{ GHz}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 5\text{ mA}; V_{CE} = 6\text{ V};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 17 | – | dB |
| | | $I_C = 5\text{ mA}; V_{CE} = 6\text{ V};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 2\text{ GHz}$ | – | 10 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 5\text{ mA}; V_{CE} = 6\text{ V};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | 13 | 14 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 6\text{ V};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 1.2 | 1.7 | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 6\text{ V};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 6\text{ V};$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 2\text{ GHz}$ | – | 1.9 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 5\text{ mA}; V_{CE} = 6\text{ V}; R_L = 50\text{ }\Omega;$ $T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 4 | – | dBm |
| ITO | third order intercept point | note 2 | – | 10 | – | dBm |

Notes

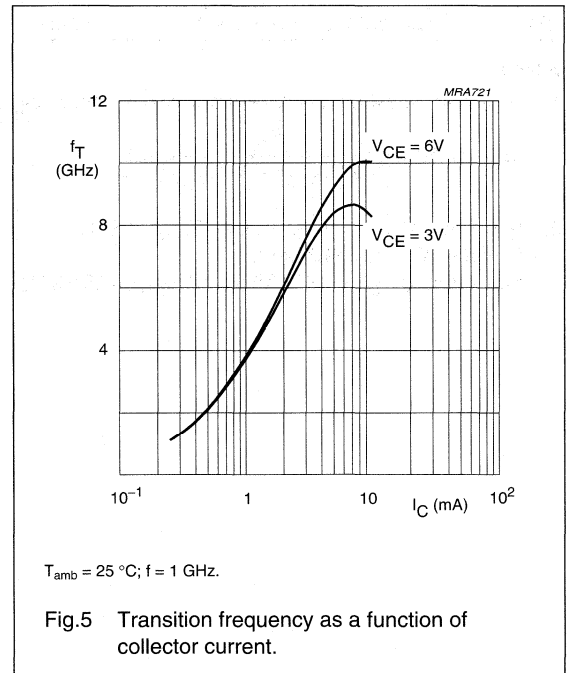
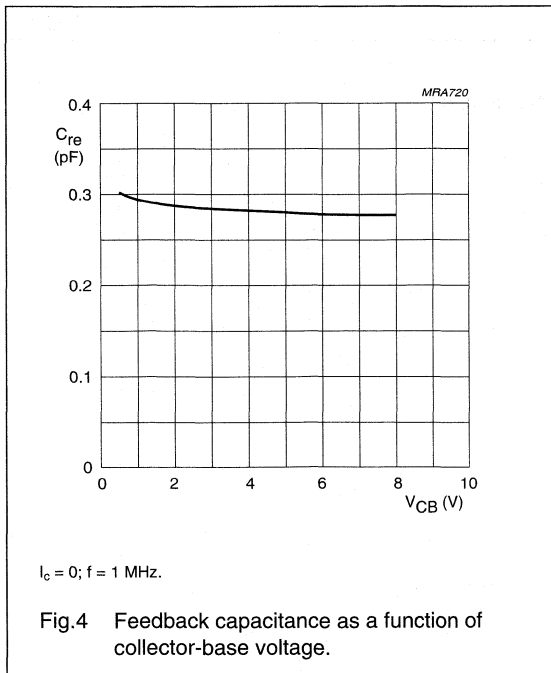
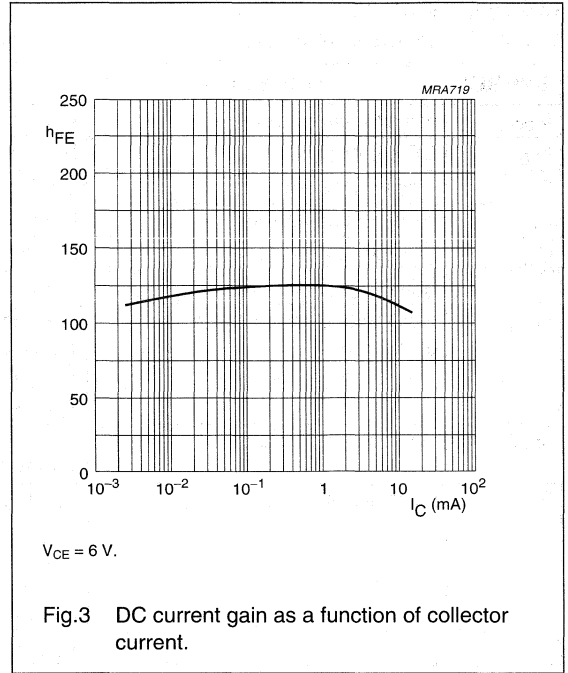
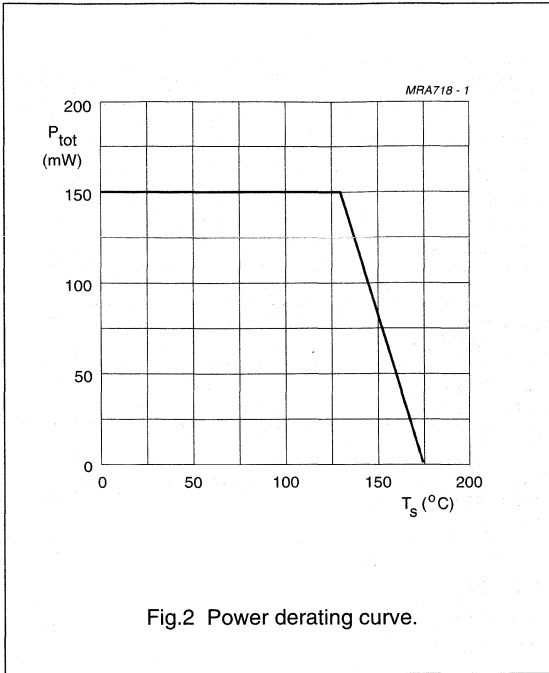
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

2. $I_C = 5\text{ mA}; V_{CE} = 6\text{ V}; R_L = 50\text{ }\Omega; T_{amb} = 25\text{ }^\circ\text{C};$
 $f_p = 900\text{ MHz}; f_q = 902\text{ MHz};$
 measured at $f_{(2p-q)} = 898\text{ MHz}$ and $f_{(2q-p)} = 904\text{ MHz}.$

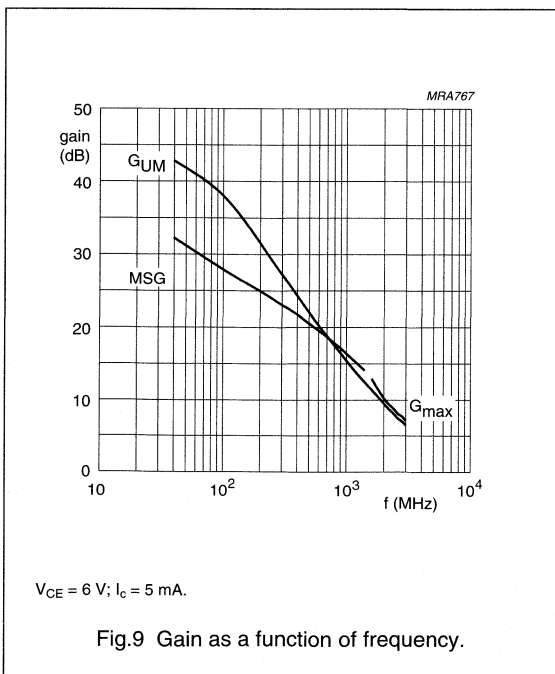
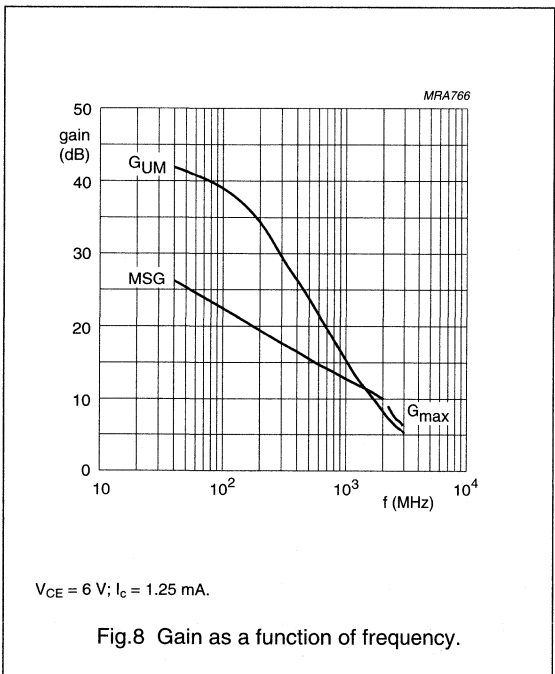
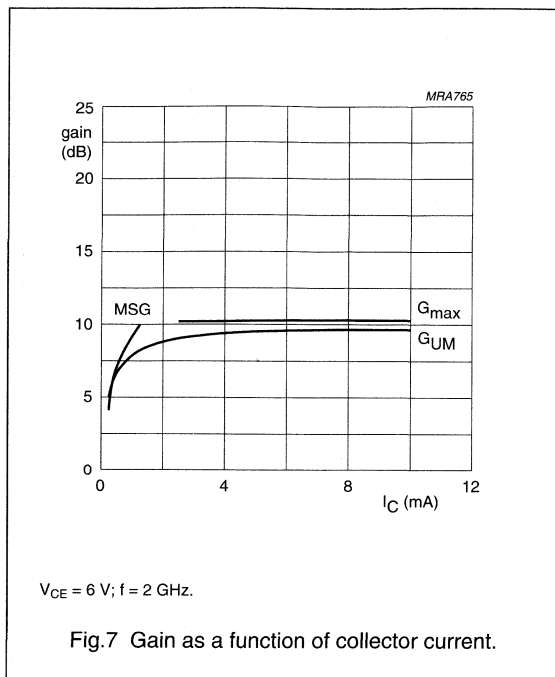
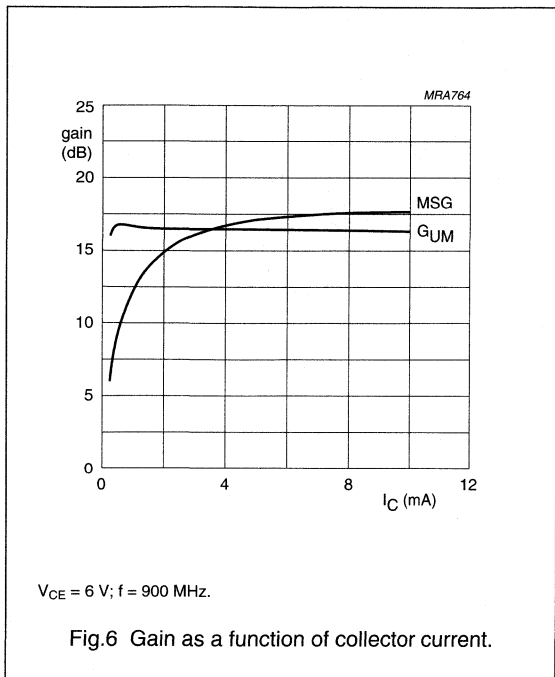
NPN 9 GHz wideband transistor

BFR505



NPN 9 GHz wideband transistor

BFR505



NPN 9 GHz wideband transistor

BFR505

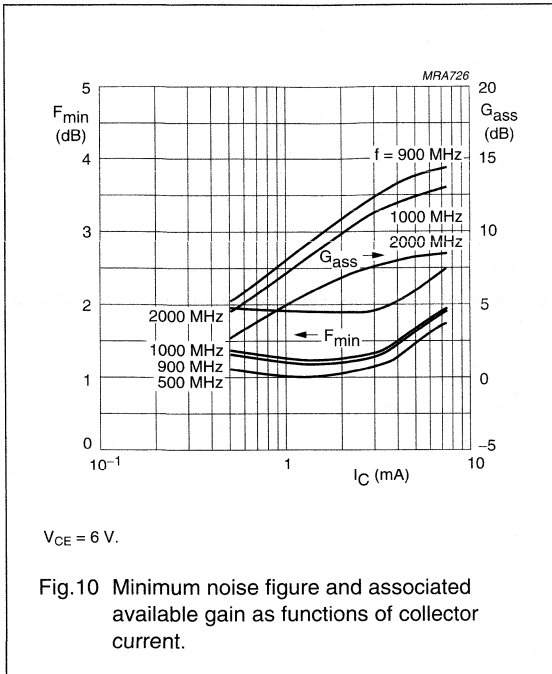


Fig.10 Minimum noise figure and associated available gain as functions of collector current.

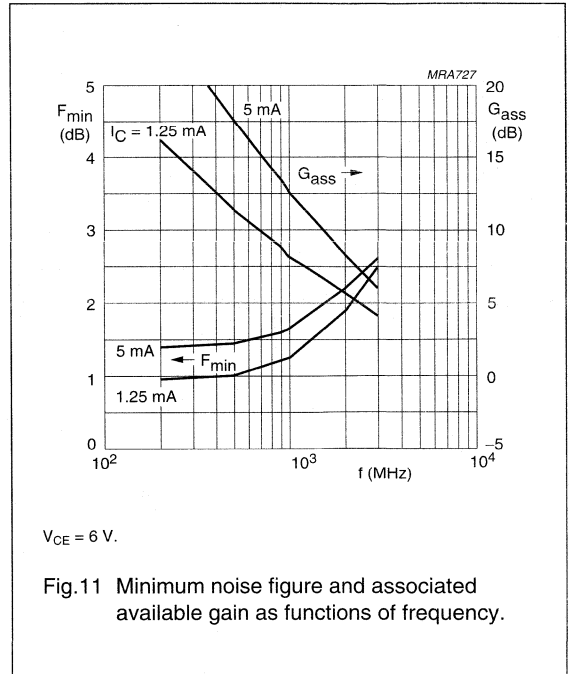


Fig.11 Minimum noise figure and associated available gain as functions of frequency.

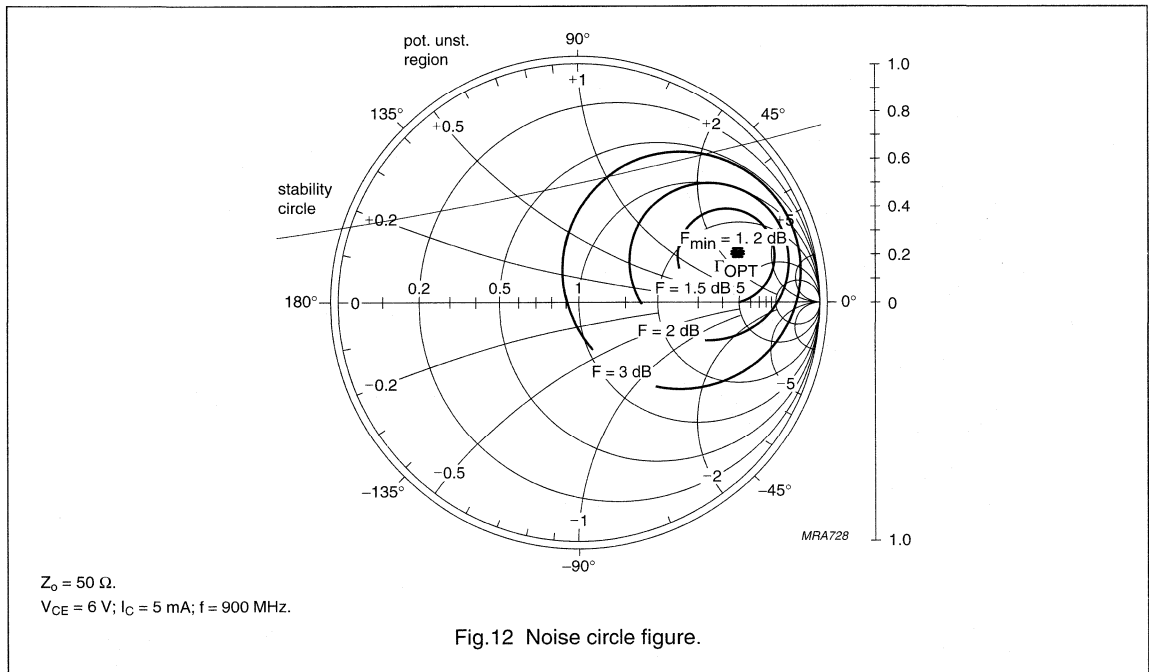
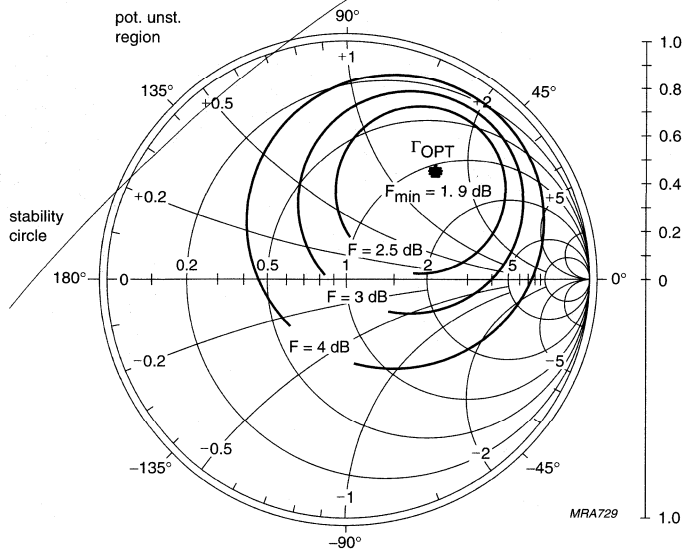


Fig.12 Noise circle figure.

NPN 9 GHz wideband transistor

BFR505

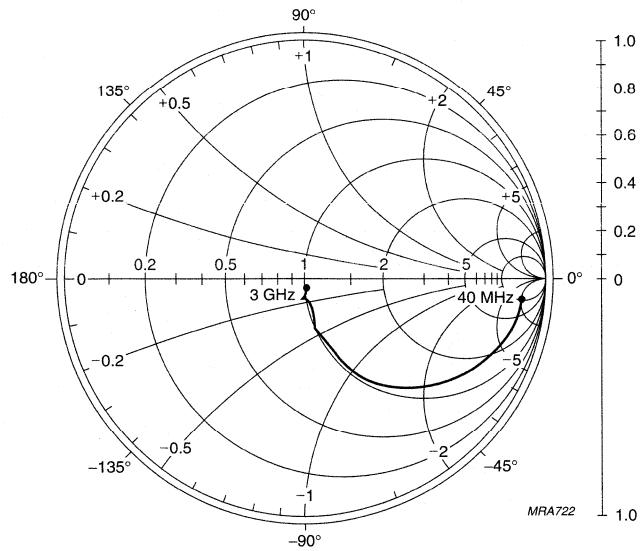


$Z_o = 50 \Omega$.
 $V_{CE} = 6 \text{ V}$; $I_C = 5 \text{ mA}$; $f = 2000 \text{ MHz}$.

Fig.13 Noise circle figure.

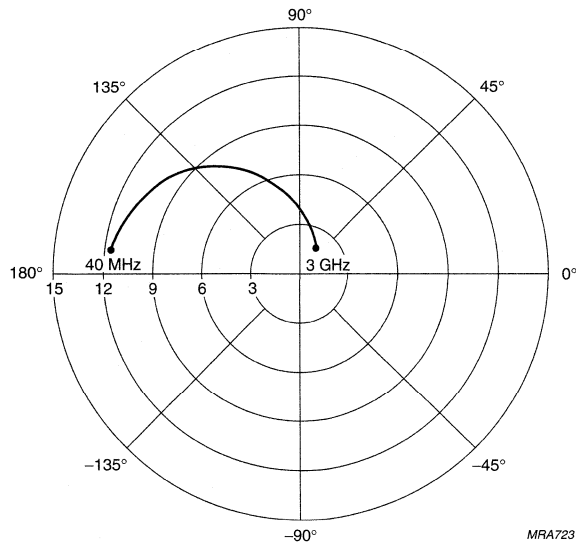
NPN 9 GHz wideband transistor

BFR505



$V_{CE} = 6 \text{ V}; I_C = 5 \text{ mA}.$
 $Z_0 = 50 \Omega.$

Fig.14 Common emitter input reflection coefficient (S_{11}).

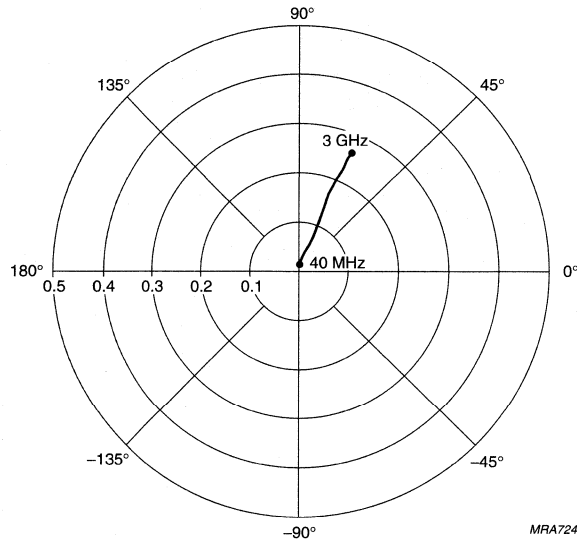


$V_{CE} = 6 \text{ V}; I_C = 5 \text{ mA}.$

Fig.15 Common emitter forward transmission coefficient (S_{21}).

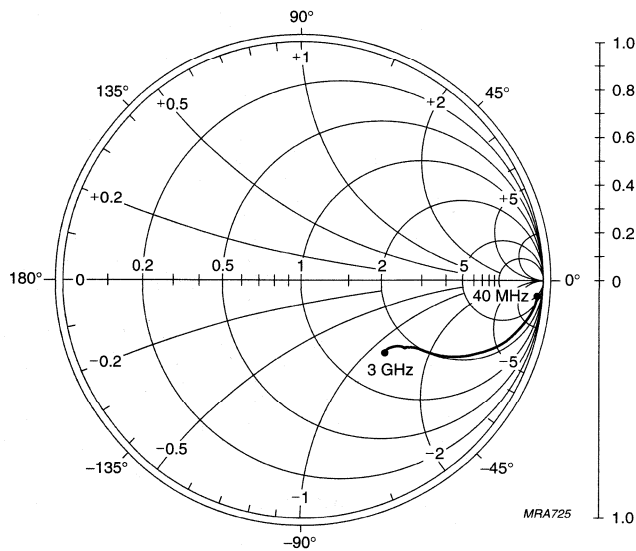
NPN 9 GHz wideband transistor

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$V_{CE} = 6\text{ V}; I_C = 5\text{ mA}$.

Fig.16 Common emitter reverse transmission coefficient (S_{12}).



$V_{CE} = 6\text{ V}; I_C = 5\text{ mA}$.
 $Z_0 = 50\ \Omega$.

Fig.17 Common emitter output reflection coefficient (S_{22}).

NPN 9 GHz wideband transistor

BFR520

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

telephones (CT1, CT2, DECT, etc.), radar detectors, pagers and satellite TV tuners (SATV) and repeater amplifiers in fibre-optic systems.

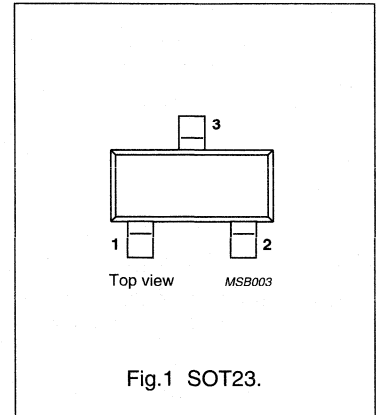
The transistor is encapsulated in a plastic SOT23 envelope.

DESCRIPTION

The BFR520 is an npn silicon planar epitaxial transistor, intended for applications in the RF frontend in wideband applications in the GHz range, such as analog and digital cellular telephones, cordless

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: N28 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | DC collector current | | – | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 97\text{ }^\circ\text{C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $I_C = i_c = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| f_T | transition frequency | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 15 | – | dB |
| | | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 9 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | 13 | 14 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 1.1 | 1.6 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 1.9 | – | dB |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFR520

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 97\text{ °C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 260 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFR520

CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|--|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 6\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $I_C = I_e = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 1 | – | pF |
| C_c | collector capacitance | $I_E = I_e = 0; V_{CB} = 6\text{ V}; f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0; V_{CB} = 6\text{ V}; f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| f_T | transition frequency | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; f = 1\text{ GHz}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 15 | – | dB |
| | | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; f = 2\text{ GHz}$ | – | 9 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | 13 | 14 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 6\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 1.1 | 1.6 | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}; I_C = 5\text{ mA}; V_{CE} = 6\text{ V}; T_{amb} = 25\text{ }^\circ\text{C}; f = 2\text{ GHz}$ | – | 1.9 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; R_L = 50\text{ } \Omega; T_{amb} = 25\text{ }^\circ\text{C}; f = 900\text{ MHz}$ | – | 17 | – | dBm |
| ITO | third order intercept point | note 2 | – | 26 | – | dBm |

Notes

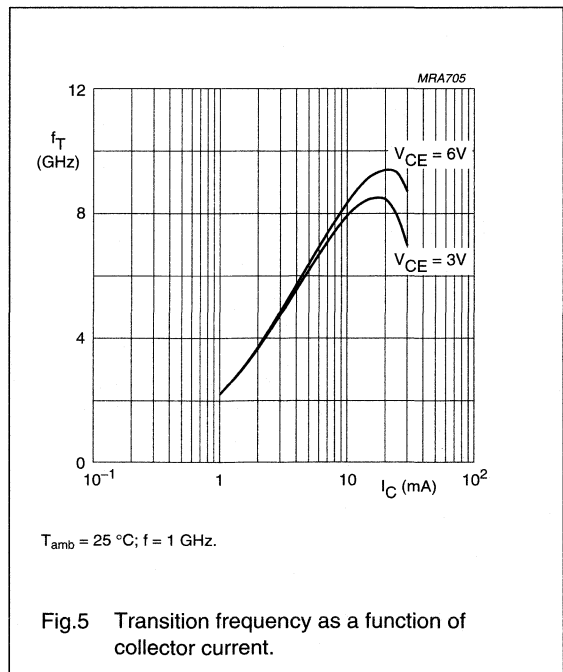
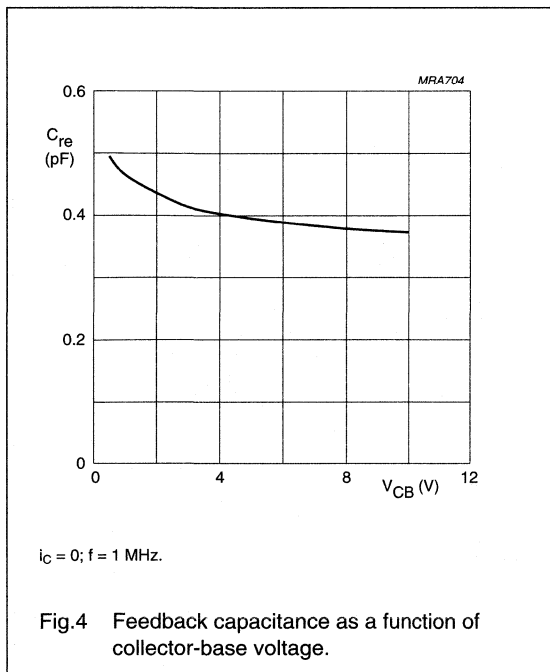
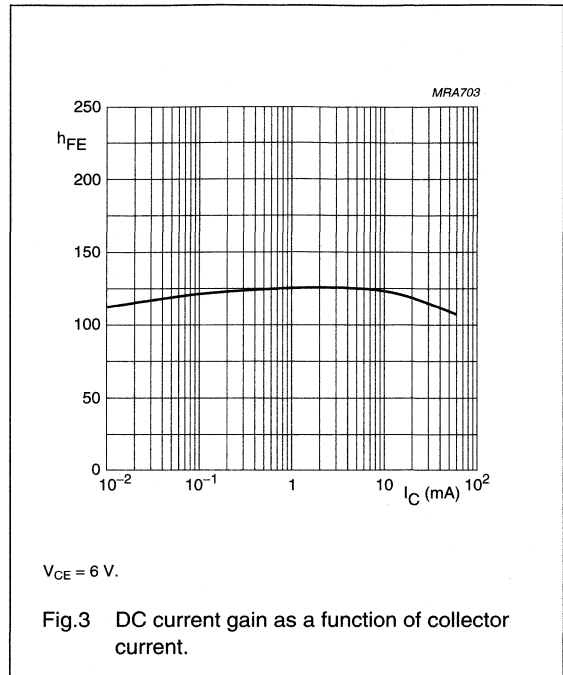
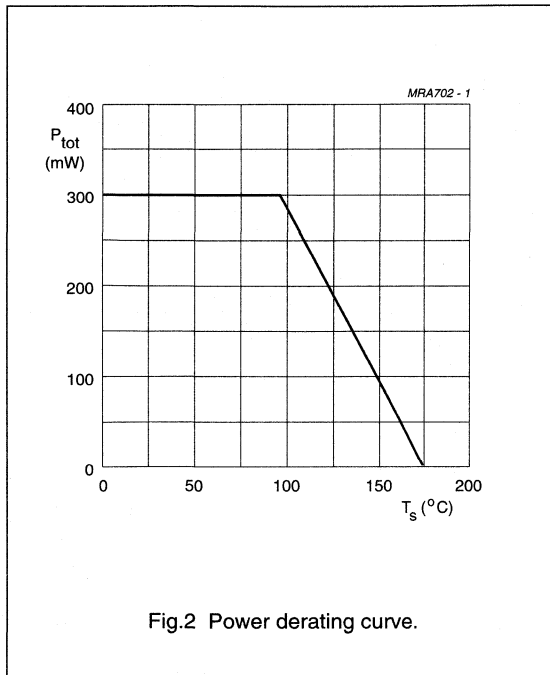
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

2. $I_C = 20\text{ mA}; V_{CE} = 6\text{ V}; R_L = 50\text{ } \Omega; T_{amb} = 25\text{ }^\circ\text{C}; f_p = 900\text{ MHz}; f_q = 902\text{ MHz};$
 measured at $f_{(2p-q)} = 898\text{ MHz}$ and $f_{(2q-p)} = 904\text{ MHz}$.

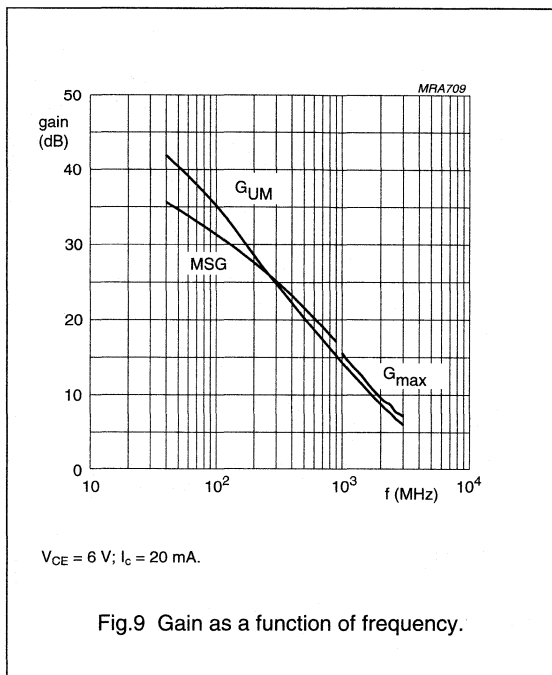
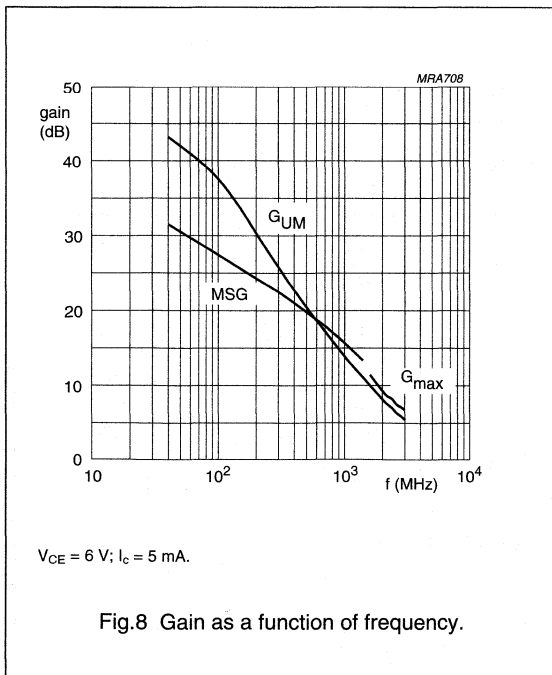
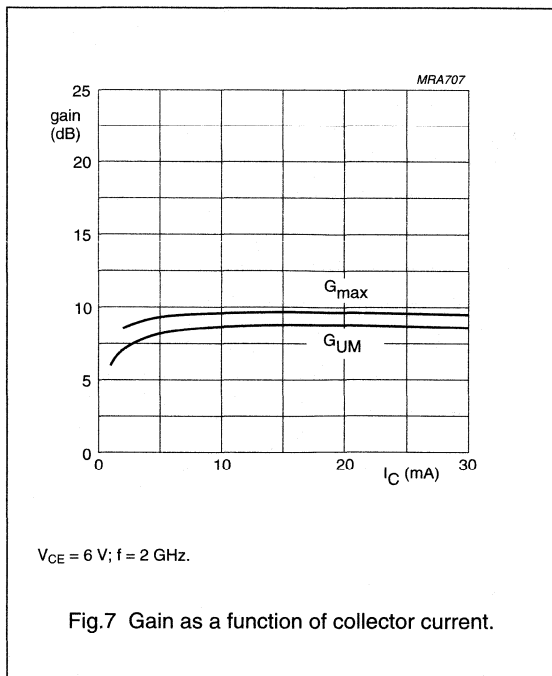
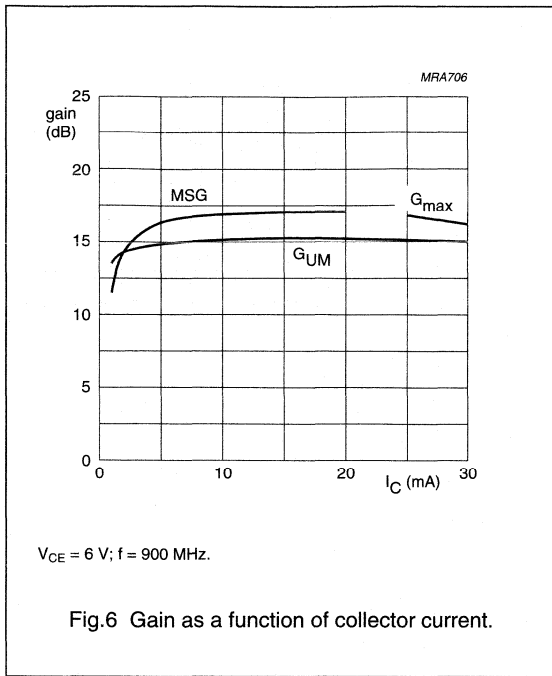
NPN 9 GHz wideband transistor

BFR520



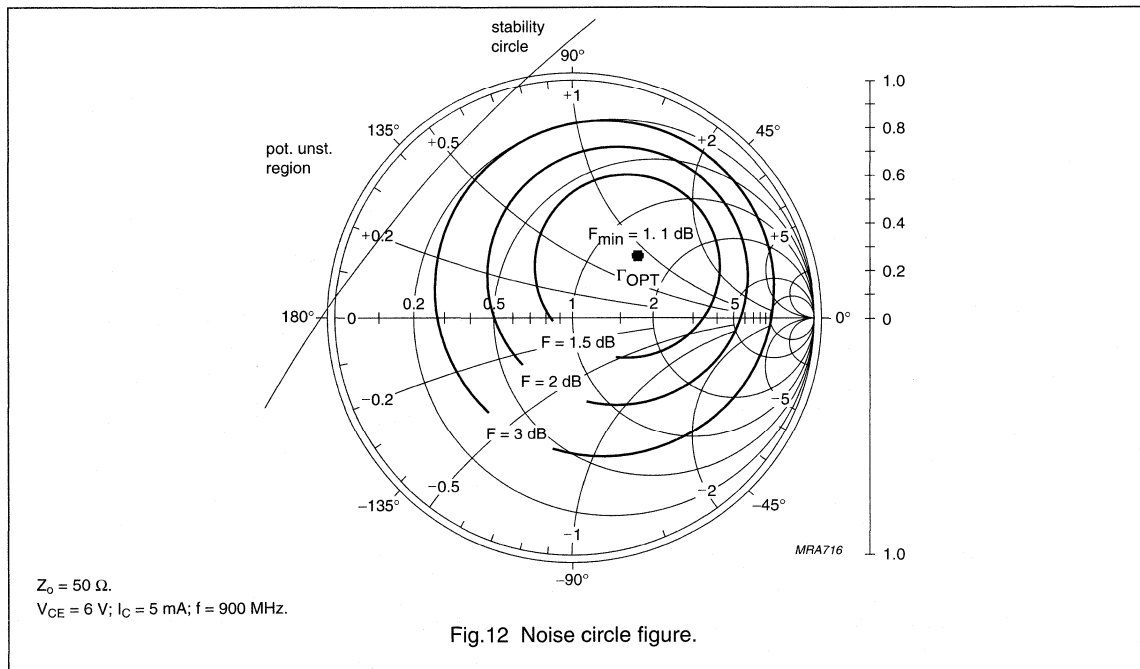
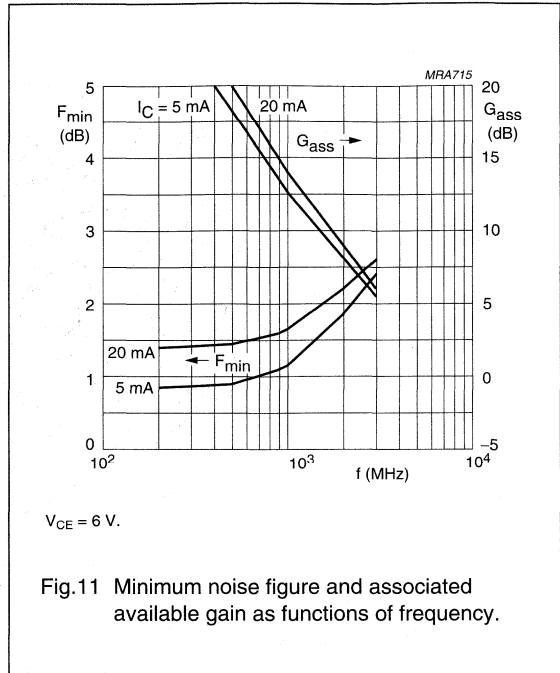
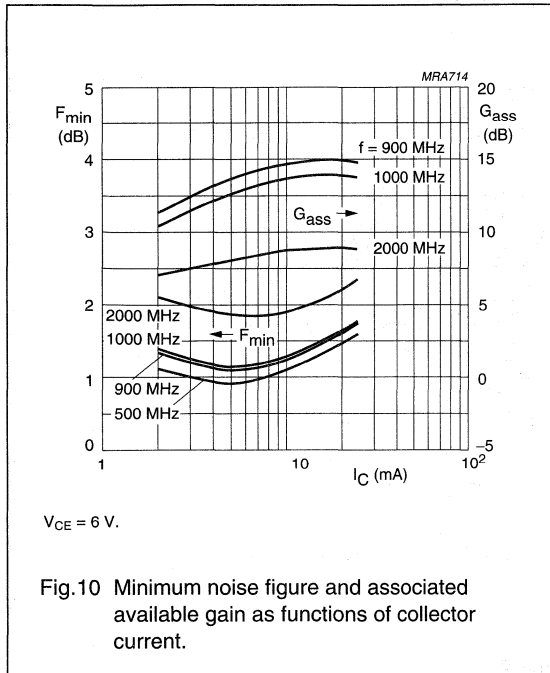
NPN 9 GHz wideband transistor

BFR520



NPN 9 GHz wideband transistor

BFR520



NPN 9 GHz wideband transistor

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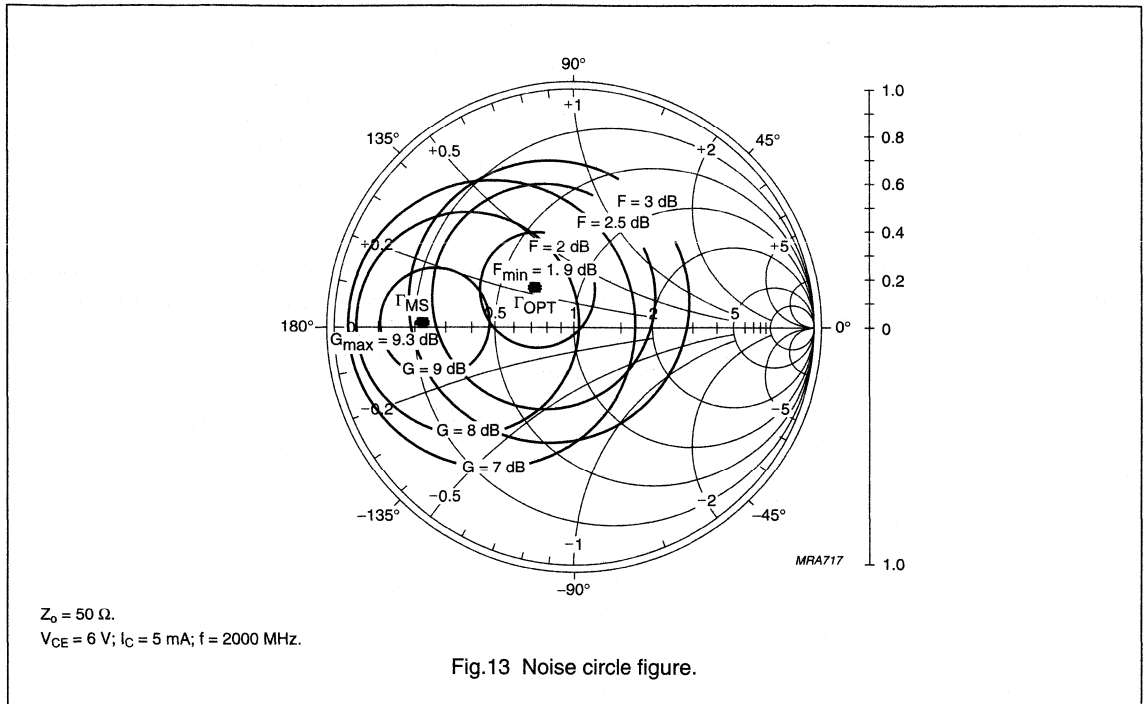
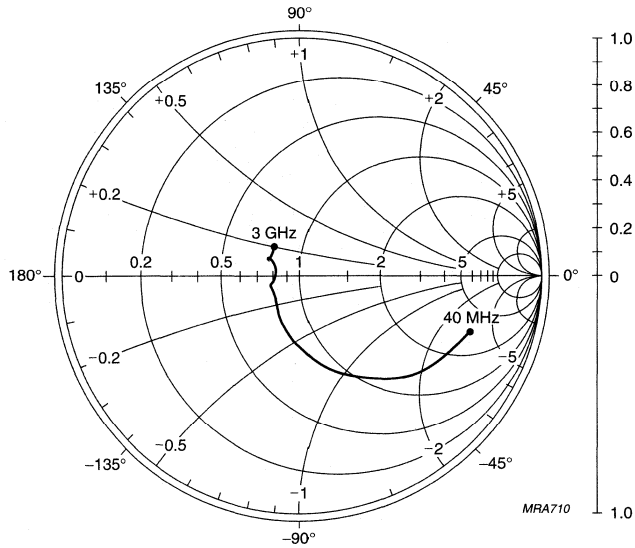


Fig.13 Noise circle figure.

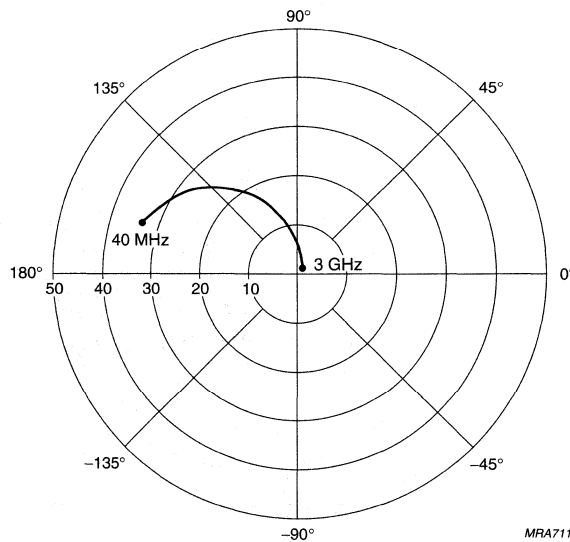
NPN 9 GHz wideband transistor

BFR520



$V_{CE} = 6\text{ V}; I_C = 20\text{ mA}.$
 $Z_0 = 50\ \Omega.$

Fig.14 Common emitter input reflection coefficient (S_{11}).

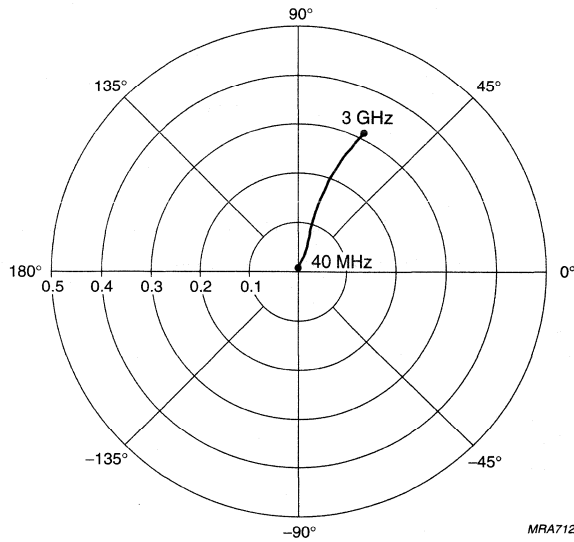


$V_{CE} = 6\text{ V}; I_C = 20\text{ mA}.$

Fig.15 Common emitter forward transmission coefficient (S_{21}).

NPN 9 GHz wideband transistor

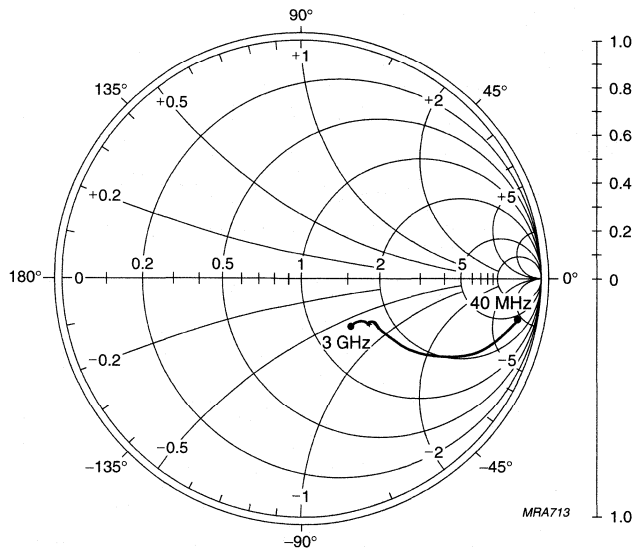
BFR520



MRA712

$V_{CE} = 6\text{ V}; I_C = 20\text{ mA}$.

Fig.16 Common emitter reverse transmission coefficient (S_{12}).



MRA713

$V_{CE} = 6\text{ V}; I_C = 20\text{ mA}$.
 $Z_0 = 50\ \Omega$.

Fig.17 Common emitter output reflection coefficient (S_{22}).

NPN 9 GHz wideband transistor

BFR540

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability.

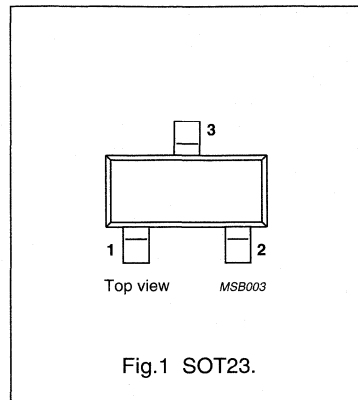
DESCRIPTION

The BFR540 is an npn silicon planar epitaxial transistor, intended for applications in the RF frontend in wideband applications in the GHz range, such as analog and digital cellular telephones, cordless telephones (CT1, CT2, DECT, etc.), radar detectors, satellite TV tuners (SATV), MATV/CATV amplifiers and repeater amplifiers in fibre-optic systems.

The transistor is encapsulated in a plastic SOT23 envelope.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: N29 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | DC collector current | | – | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ °C}$; note 1 | – | – | 500 | mW |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$ | 60 | 120 | 250 | |
| C_{re} | feedback capacitance | $I_C = I_C = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.6 | – | pF |
| f_T | transition frequency | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 900\text{ MHz}$ | – | 14 | – | dB |
| | | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 2\text{ GHz}$ | – | 7 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 900\text{ MHz}$ | 12 | 13 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 900\text{ MHz}$ | – | 1.3 | 1.8 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 900\text{ MHz}$ | – | 1.9 | 2.4 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ °C}$; $f = 2\text{ GHz}$ | – | 2.1 | – | dB |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFR540

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ °C}$; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 210 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFR540

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 8\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 2 | – | pF |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.9 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.6 | – | pF |
| f_T | transition frequency | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 14 | – | dB |
| | | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 7 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | 12 | 13 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 1.3 | 1.8 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 1.9 | 2.4 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 2\text{ GHz}$ | – | 2.1 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$ | – | 21 | – | dBm |
| ITO | third order intercept point | note 2 | – | 34 | – | dBm |
| V_o | output voltage (note 3) | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $Z_L = Z_S = 75\text{ }\Omega$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 550 | – | mV |

Notes

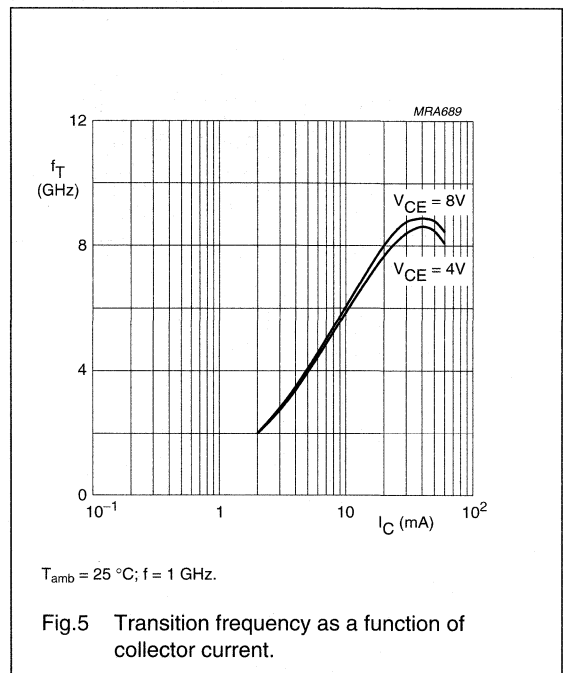
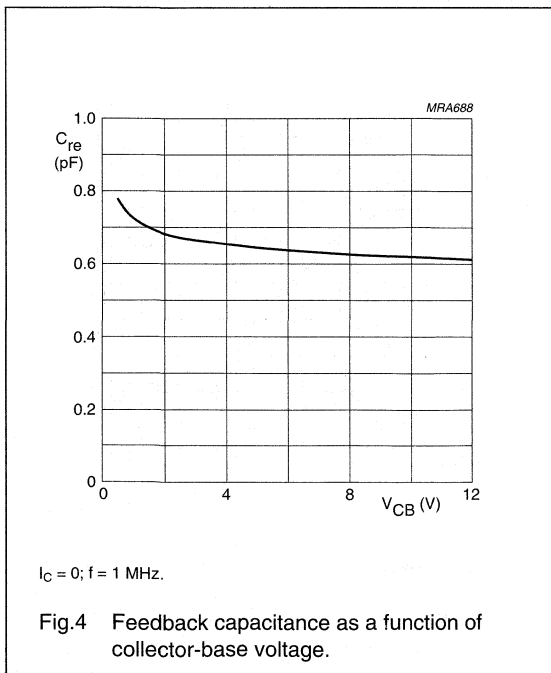
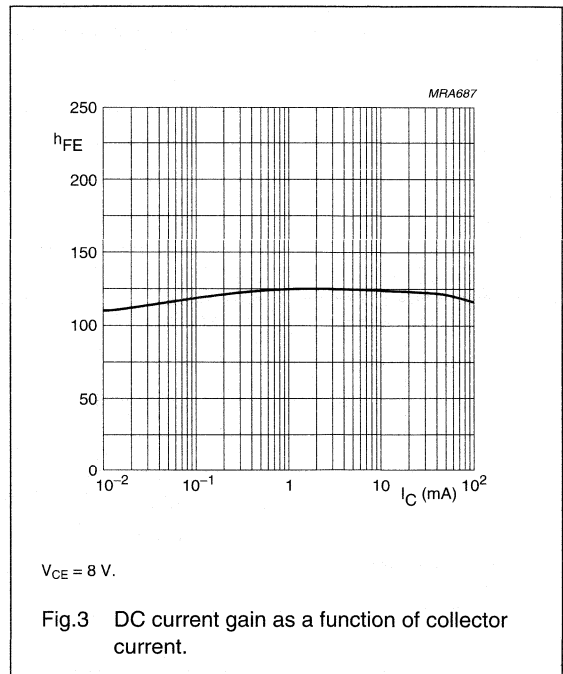
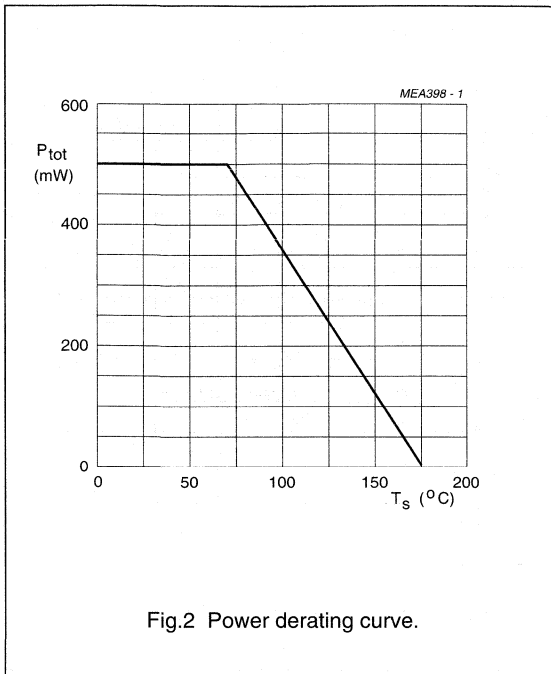
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

2. $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$;
 $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 900\text{ MHz}$;
 $f_p = 900\text{ MHz}$; $f_q = 902\text{ MHz}$;
 measured at $f_{(2p-q)} = 898\text{ MHz}$ and $f_{(2q-p)} = 904\text{ MHz}$.
3. $d_{im} = -60\text{ dB}$ (DIN 45004B);
 $V_p = V_O$; $V_q = V_O - 6\text{ dB}$; $f_p = 795.25\text{ MHz}$;
 $V_R = V_O - 6\text{ dB}$; $f_q = 803.25\text{ MHz}$; $f_r = 805.25\text{ MHz}$;
 measured at $f_{(p+q+r)} = 793.25\text{ MHz}$; preliminary data.

NPN 9 GHz wideband transistor

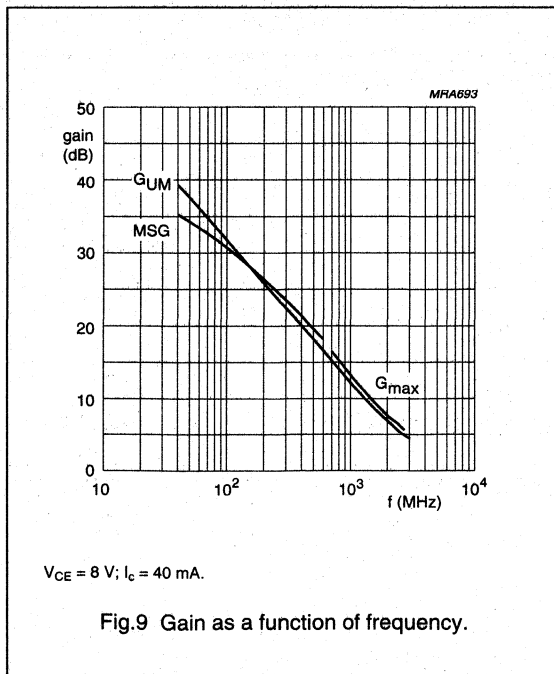
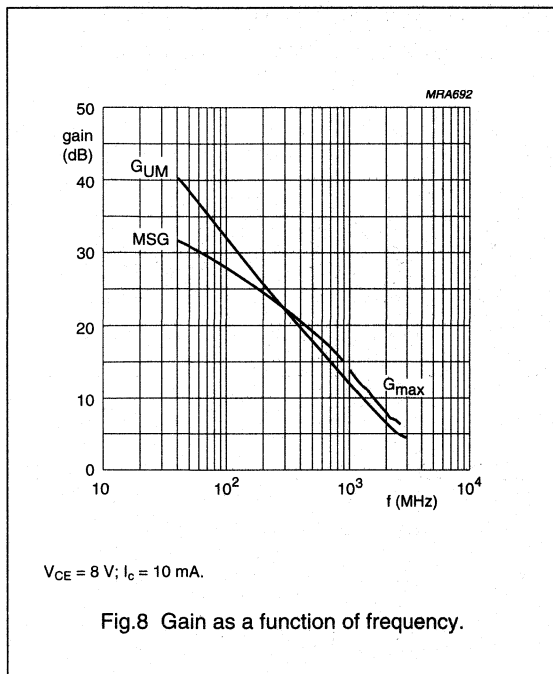
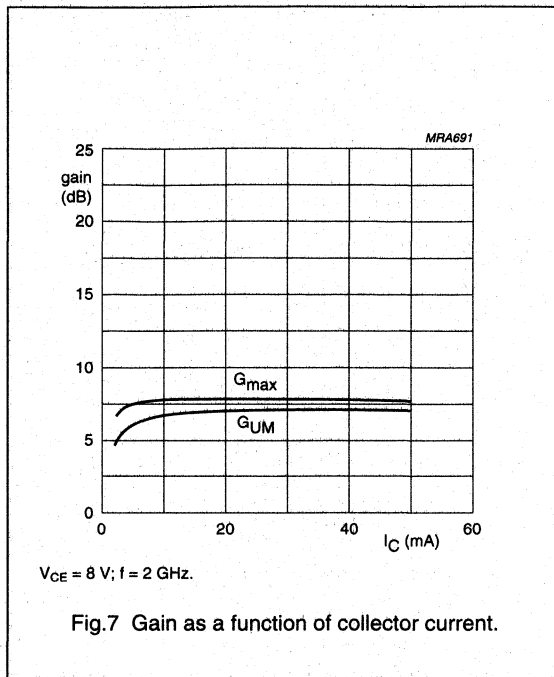
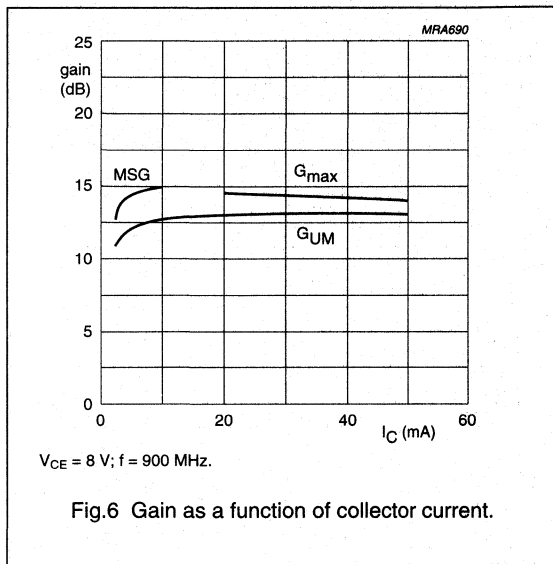
BFR540



NPN 9 GHz wideband transistor

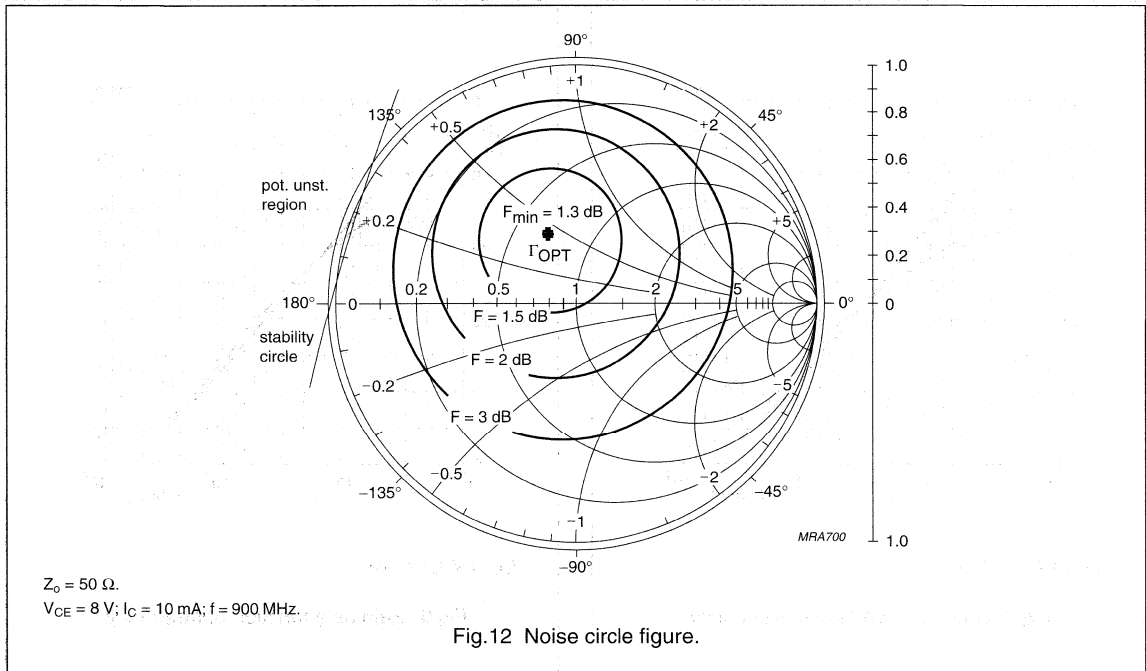
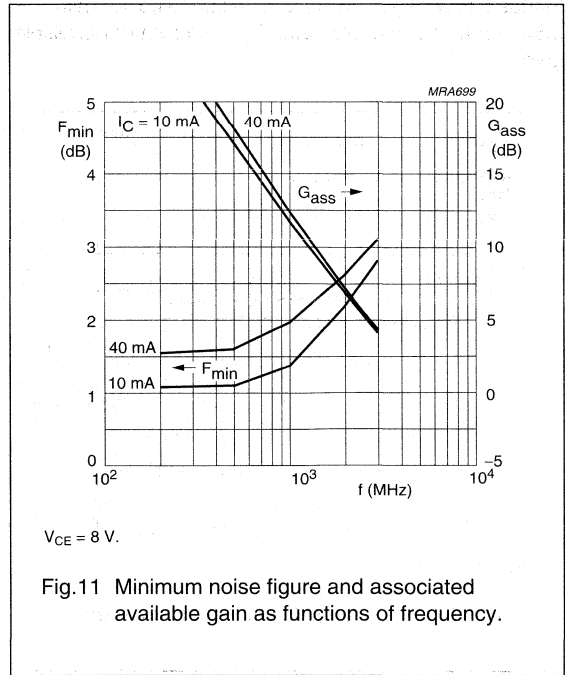
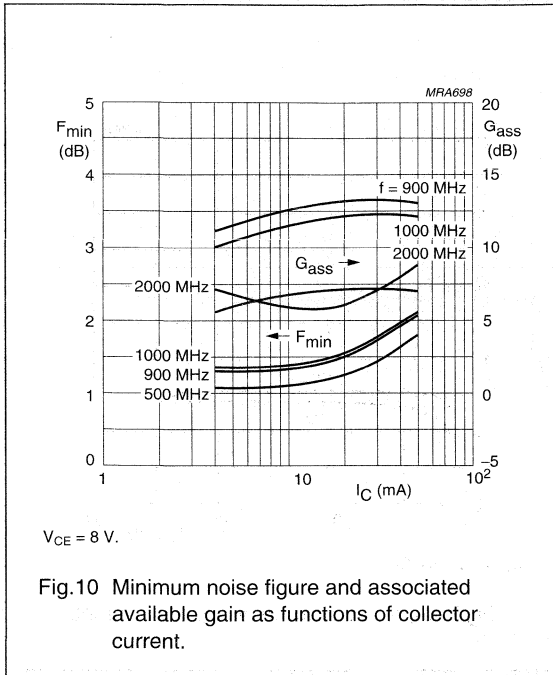
BFR540

In Figs 6 to 9, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



NPN 9 GHz wideband transistor

BFR540



NPN 9 GHz wideband transistor

BFR540

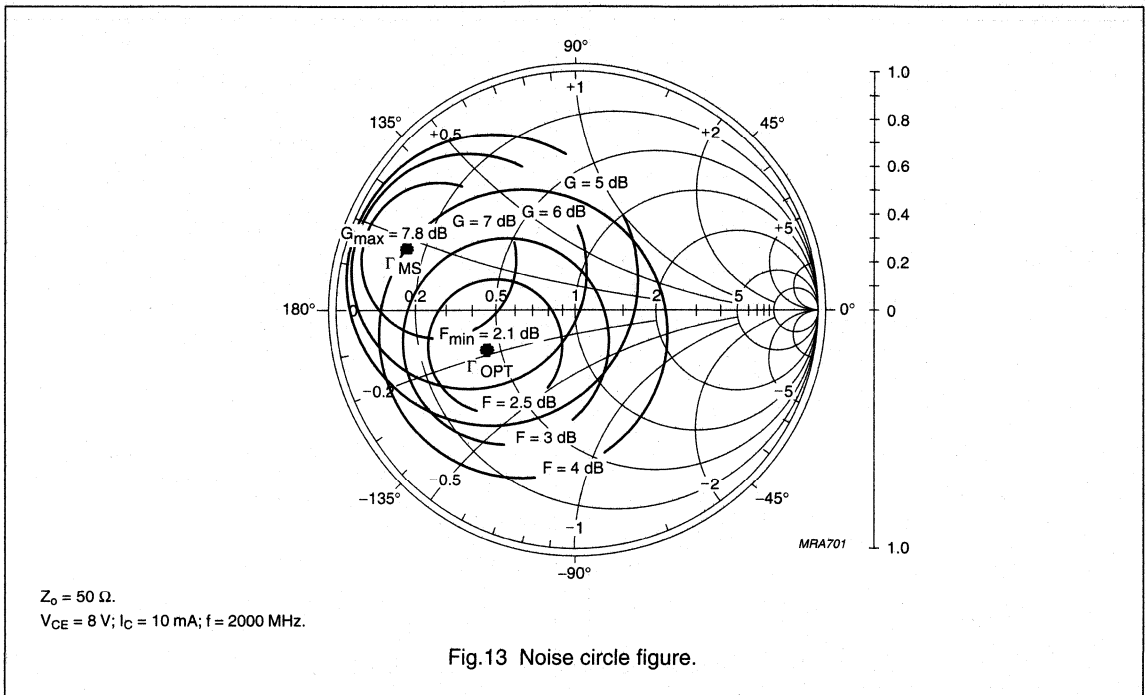
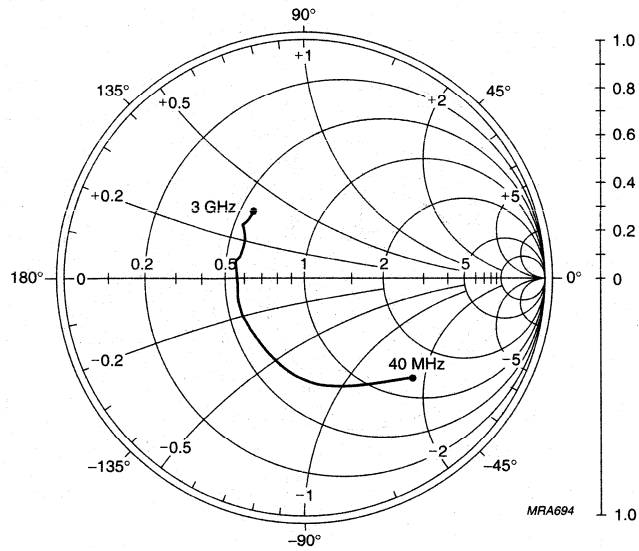


Fig.13 Noise circle figure.

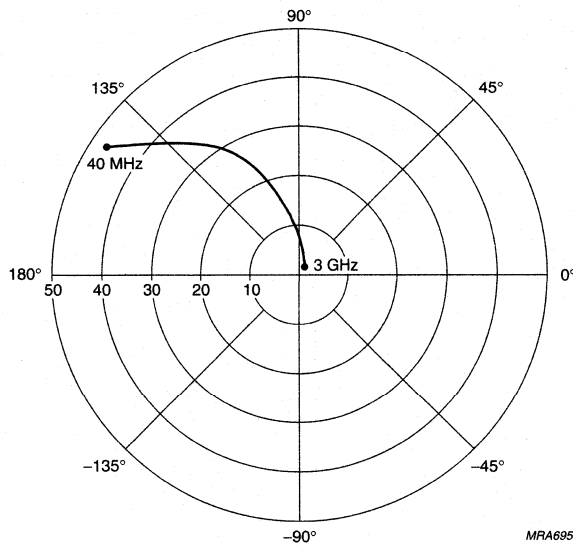
NPN 9 GHz wideband transistor

BFR540



$V_{CE} = 8 \text{ V}; I_C = 40 \text{ mA}.$
 $Z_o = 50 \Omega.$

Fig.14 Common emitter input reflection coefficient (S_{11}).

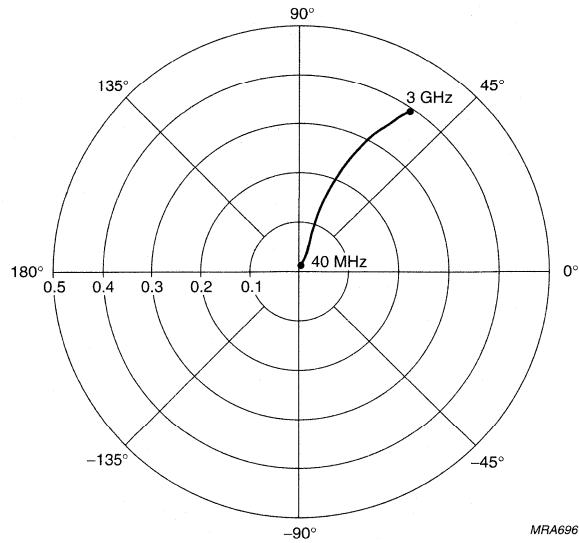


$V_{CE} = 8 \text{ V}; I_C = 40 \text{ mA}.$

Fig.15 Common emitter forward transmission coefficient (S_{21}).

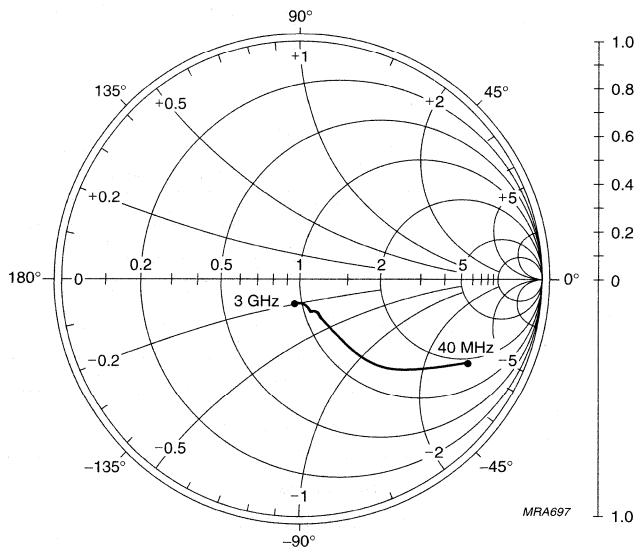
NPN 9 GHz wideband transistor

BFR540



$V_{CE} = 8 \text{ V}; I_C = 40 \text{ mA}.$

Fig.16 Common emitter reverse transmission coefficient (S_{12}).



$V_{CE} = 8 \text{ V}; I_C = 40 \text{ mA}.$
 $Z_0 = 50 \Omega.$

Fig.17 Common emitter output reflection coefficient (S_{22}).

NPN 1 GHz wideband transistor

BFS17

DESCRIPTION

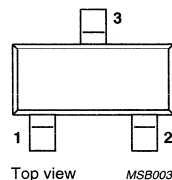
NPN transistor in a plastic SOT23 package.

APPLICATIONS

- A wide range of RF applications such as:
 - Mixers and oscillators in TV tuners
 - RF communications equipment.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



Marking code: E1p.

Fig.1 SOT23.

QUICK REFERENCED DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| I_C | DC collector current | | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ °C}$; note 1 | – | 300 | mW |
| f_T | transition frequency | $I_C = 25\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ °C}$ | 1 | – | GHz |
| F | noise figure | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $R_S = 50\text{ }\Omega$; $f = 500\text{ MHz}$; $T_j = 25\text{ °C}$ | 4.5 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 25 | mA |
| I_{CM} | peak collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ °C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 150 | °C |

Note to the Quick reference data and the Limiting values

1. T_s is the temperature at the soldering point of the collector pin.

NPN 1 GHz wideband transistor

BFS17

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|-------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 70\text{ °C}$; note 1 | 260 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

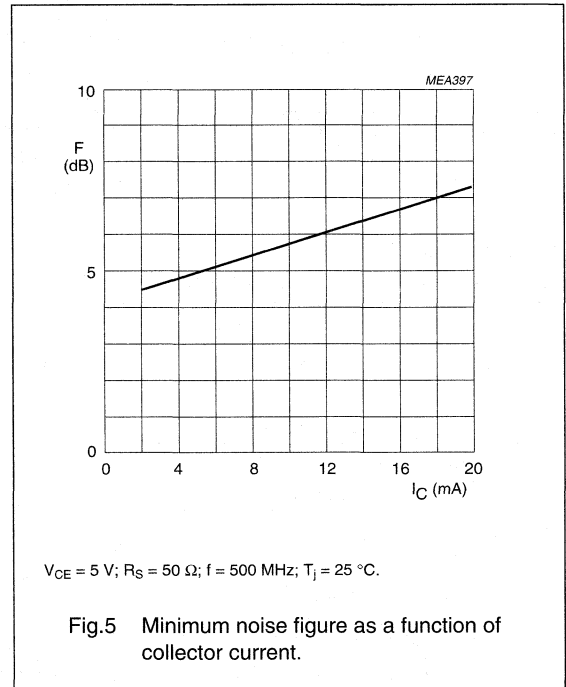
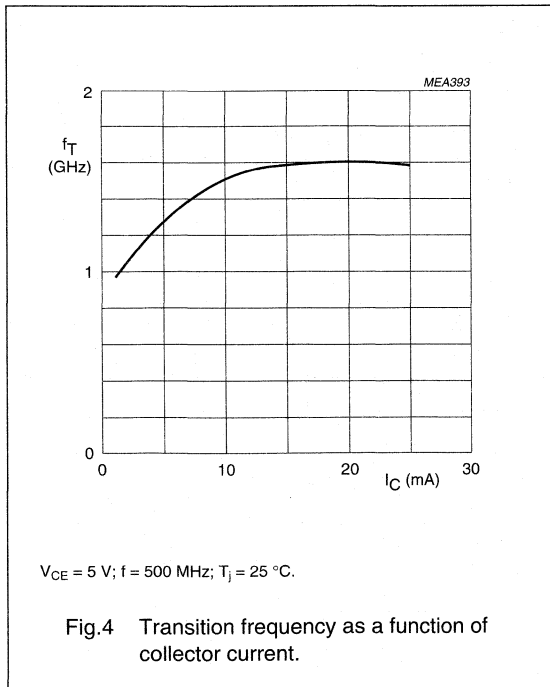
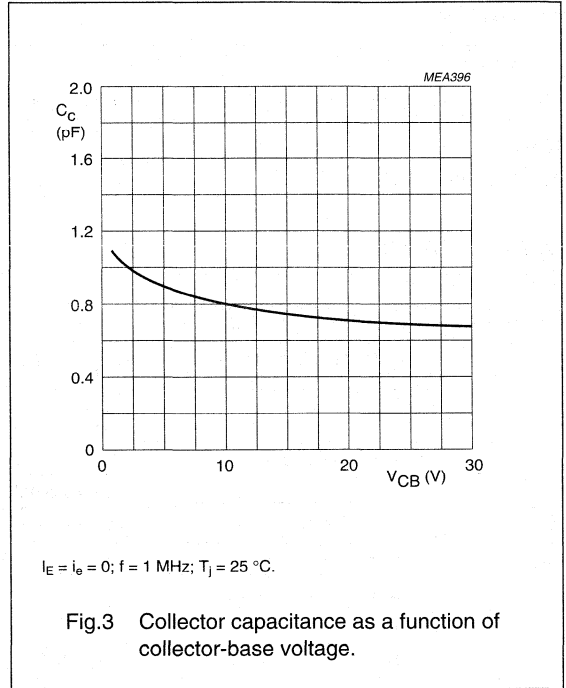
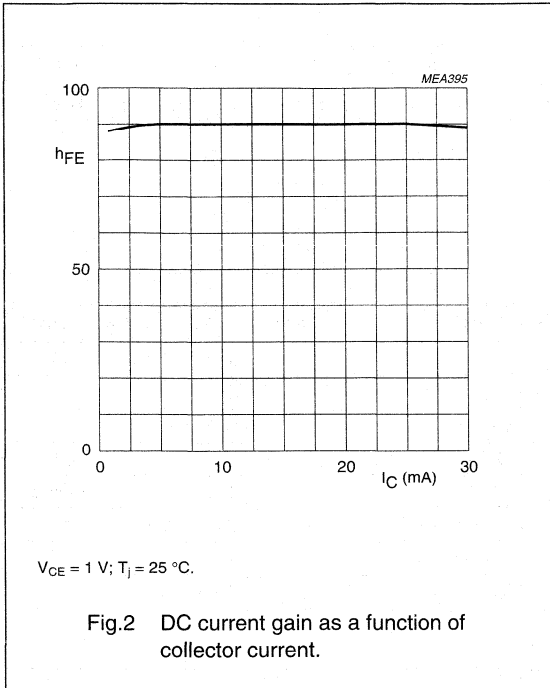
CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 10 | nA |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}$; $V_{CE} = 1\text{ V}$ | 25 | 90 | – | |
| | | $I_C = 25\text{ mA}$; $V_{CE} = 1\text{ V}$ | 25 | 90 | – | |
| f_T | transition frequency | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$ | – | 1 | – | GHz |
| | | $I_C = 25\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$ | – | 1.6 | – | GHz |
| C_c | collector capacitance | $I_E = I_B = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.8 | 1.5 | pF |
| C_e | emitter capacitance | $I_C = I_C = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | – | 2 | pF |
| C_{re} | feedback capacitance | $I_C = 1\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.65 | – | pF |
| F | noise figure | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $R_S = 50\text{ }\Omega$; $f = 500\text{ MHz}$ | – | 4.5 | – | dB |

NPN 1 GHz wideband transistor

BFS17



NPN 3 GHz wideband transistor

BFS17A

DESCRIPTION

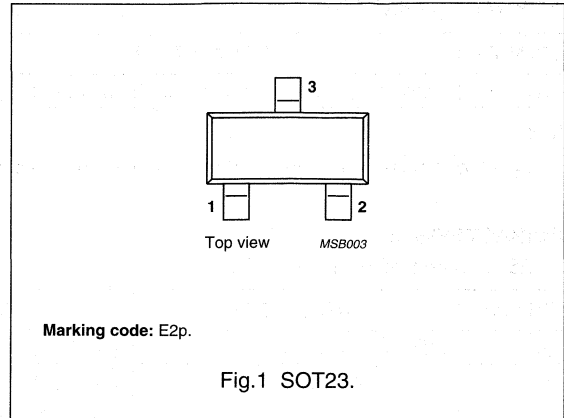
NPN transistor in a plastic SOT23 package.

APPLICATIONS

- It is intended for RF applications such as oscillators in TV tuners.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| I_C | DC collector current | | – | 25 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| f_T | transition frequency | $I_C = 25\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 2.8 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 800\text{ MHz}$ | 13.5 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 2.5 | – | dB |
| V_O | output voltage | $d_{im} = -60\text{ dB}$; $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\text{ }\Omega$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f_{(p+q-t)} = 793.25\text{ MHz}$ | 150 | – | mV |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|---|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 25 | mA |
| I_{CM} | peak collector current | | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 70\text{ }^\circ\text{C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 150 | $^\circ\text{C}$ |

Note to the Quick reference data and the Limiting values

- T_s is the temperature at the soldering point of the collector pin.

NPN 3 GHz wideband transistor

BFS17A

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|-------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 70\text{ °C}$; note 1 | 260 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

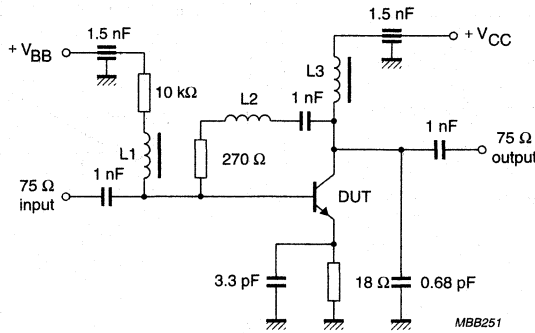
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 10\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ °C}$ | 25 | 90 | – | |
| | | $I_C = 25\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ °C}$ | 25 | 90 | – | |
| f_T | transition frequency | $I_C = 25\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 2.8 | – | GHz |
| C_c | collector capacitance | $I_E = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 0.7 | – | pF |
| C_e | emitter capacitance | $I_C = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.25 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.6 | – | pF |
| G_{UM} | maximum unilateral power gain note 1 | $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $f = 800\text{ MHz}$ | – | 13.5 | – | dB |
| F | noise figure | $I_C = 2\text{ mA}$; $V_{CE} = 5\text{ V}$; $Z_S = 60\text{ }\Omega$; $f = 800\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 2.5 | – | dB |
| V_O | output voltage | note 2 | – | 150 | – | mV |

Notes

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and $G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)}$ dB.
- $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = 14\text{ mA}$; $V_{CE} = 10\text{ V}$; $R_L = 75\text{ }\Omega$; $T_{amb} = 25\text{ °C}$;
 $V_p = V_O$; $f_p = 795.25\text{ MHz}$;
 $V_q = V_O - 6\text{ dB}$; $f_q = 803.25\text{ MHz}$;
 $V_r = V_O - 6\text{ dB}$; $f_r = 805.25\text{ MHz}$;
 measured at $f_{(p+q-r)} = 793.25\text{ MHz}$.

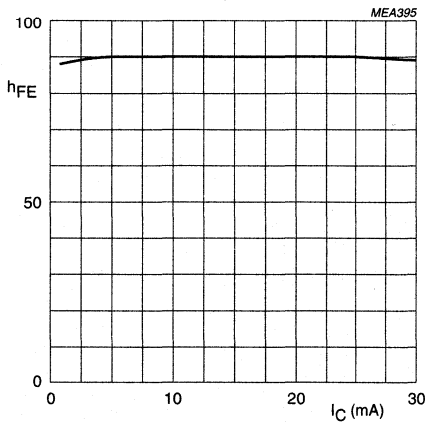
NPN 3 GHz wideband transistor

BFS17A



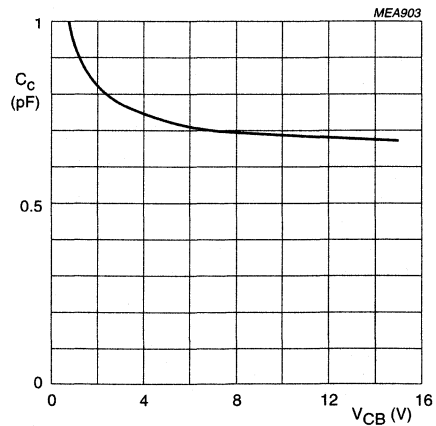
L1 = L3 = 5 μH Ferroxcube choke.
 L2 = 3 turns 0.4 mm copper wire; winding pitch 1 mm; internal diameter 3 mm.

Fig.2 Intermodulation distortion and second order intermodulation distortion test circuit.



V_{CE} = 1 V; T_{amb} = 25 °C.

Fig.3 DC current gain as a function of collector current.

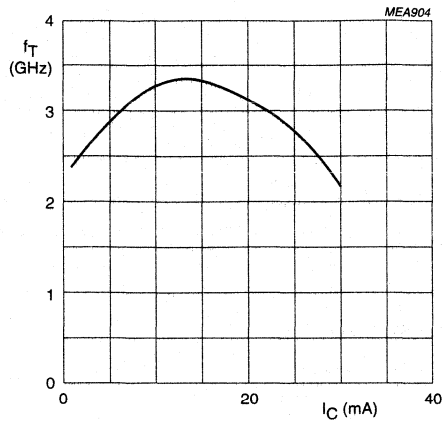


I_E = 0; f = 1 MHz; T_{amb} = 25 °C.

Fig.4 Collector capacitance as a function of collector-base voltage.

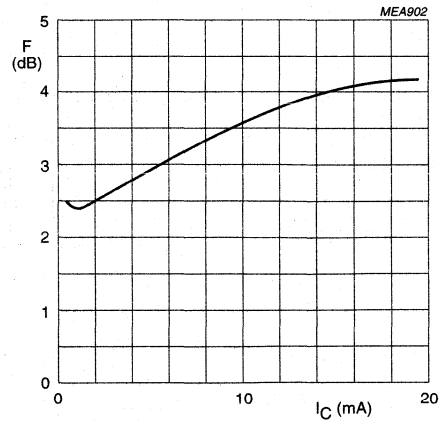
NPN 3 GHz wideband transistor

BFS17A



$V_{CE} = 5 \text{ V}$; $f = 500 \text{ MHz}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.5 Transition frequency as a function of collector current.



$V_{CE} = 5 \text{ V}$; $Z_s = 60 \text{ } \Omega$; $f = 800 \text{ MHz}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.6 Minimum noise figure as a function of collector current.

NPN 1 GHz wideband transistor

BFS17W

APPLICATIONS

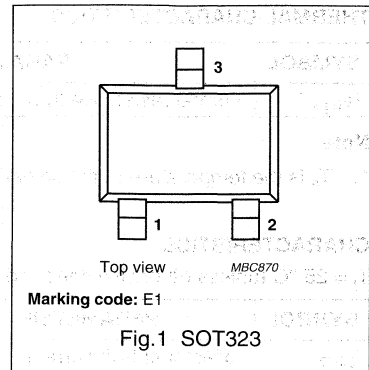
Primarily intended as a mixer, oscillator and IF amplifier in UHF and VHF tuners.

DESCRIPTION

Silicon NPN transistor in a plastic SOT323 (S-mini) package. The BFS17W uses the same crystal as the SOT23 version, BFS17.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | | – | – | 25 | V |
| V_{CEO} | collector-emitter voltage | | – | – | 15 | V |
| I_C | DC collector current | | – | – | 50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ °C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}$; $V_{CE} = 1\text{ V}$ | 25 | 90 | – | |
| f_T | transition frequency | $I_C = 25\text{ mA}$; $V_{CE} = 5\text{ V}$ | – | 1.6 | – | GHz |
| C_C | collector capacitance | $I_E = 0$; $V_{CB} = 10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.8 | 1.5 | pF |
| C_{re} | feedback capacitance | $I_C = 1\text{ mA}$; $V_{CE} = 5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.75 | – | pF |
| T_j | junction temperature | | – | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector pin.

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 25 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 50 | mA |
| P_{tot} | total power dissipation | $T_s = 118\text{ °C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector pin.

NPN 1 GHz wideband transistor

BFS17W

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|--|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 118\text{ }^\circ\text{C}$; note 1 | 190 | K/W |

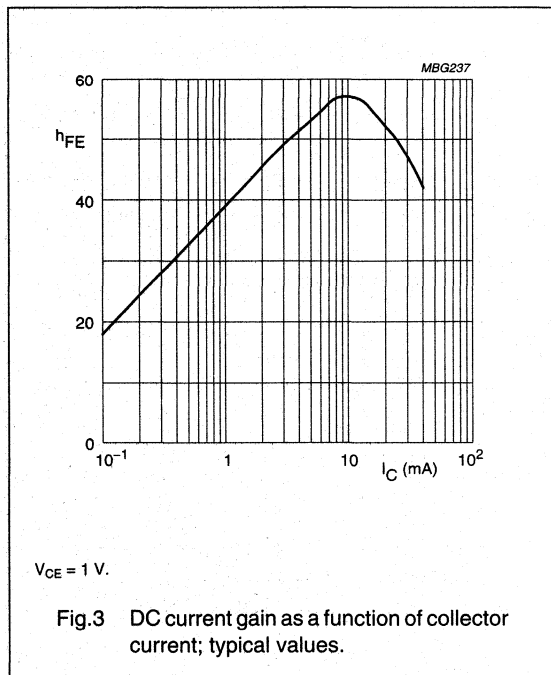
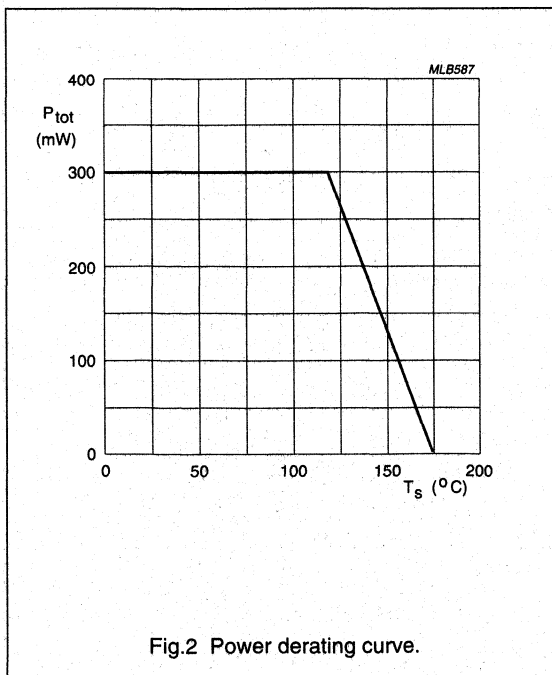
Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

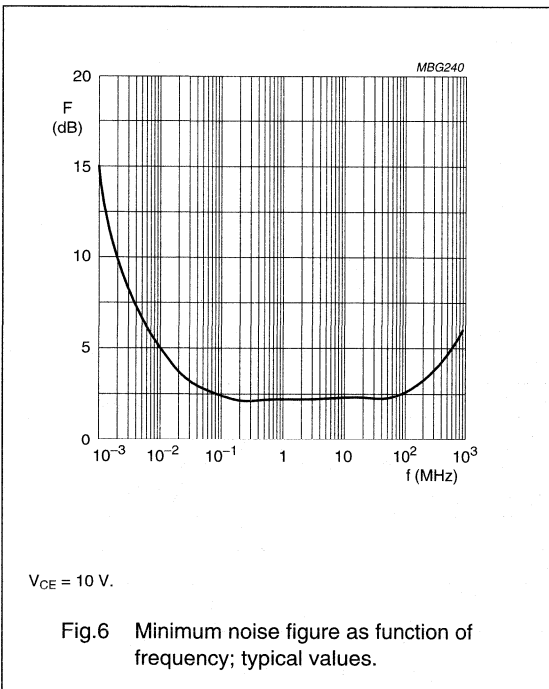
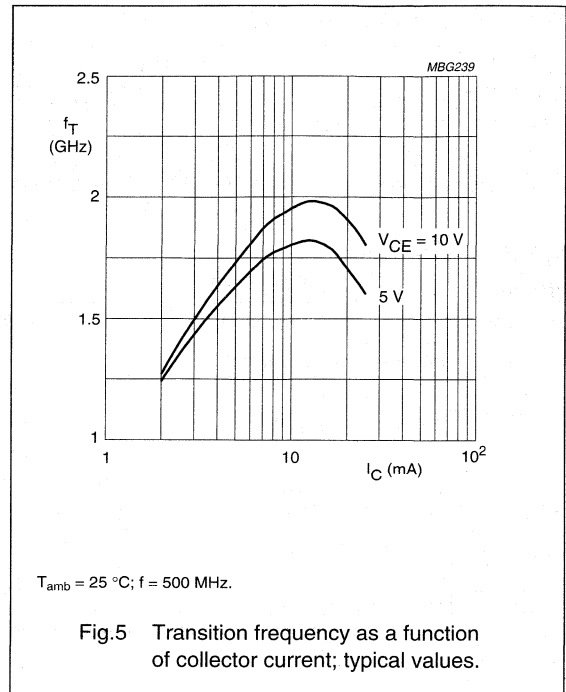
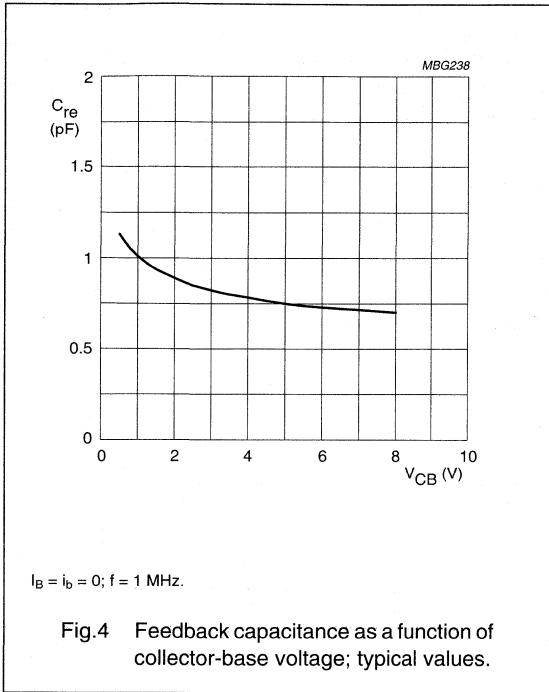
$T_j = 25\text{ }^\circ\text{C}$ (unless otherwise specified).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = 10\text{ V}$ | – | – | 10 | nA |
| h_{FE} | DC current gain | $I_C = 2\text{ mA}; V_{CE} = 1\text{ V}$ | 25 | 90 | – | |
| f_T | transition frequency | $I_C = 25\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}$ | – | 1.6 | – | GHz |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = 10\text{ V}; f = 1\text{ MHz}$ | – | 0.8 | 1.5 | pF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 2 | – | pF |
| C_{re} | feedback capacitance | $I_B = i_b = 0; V_{CE} = 5\text{ V}; f = 1\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 0.75 | – | pF |
| F | noise figure | $I_C = 2\text{ mA}; V_{CE} = 5\text{ V}; f = 500\text{ MHz}; \Gamma_S = \Gamma_{opt}$ | – | 4.5 | – | dB |



NPN 1 GHz wideband transistor

BFS17W



NPN 5 GHz wideband transistor

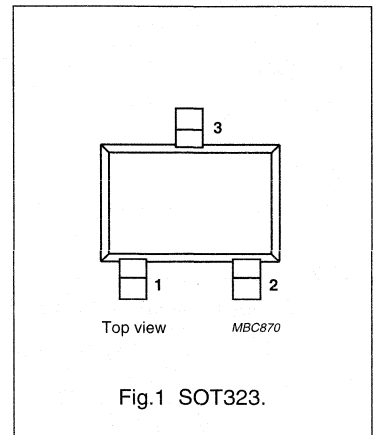
BFS25A

FEATURES

- Low current consumption
- Low noise figure
- Gold metallization ensures excellent reliability
- SOT323 envelope.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: N6 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



DESCRIPTION

NPN transistor in a plastic SOT323 envelope.

It is designed for use in RF amplifiers and oscillators in pagers and pocket phones with signal frequencies up to 2 GHz.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 8 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 5 | V |
| I_C | DC collector current | | – | – | 6.5 | mA |
| P_{tot} | total power dissipation | up to $T_s = 170\text{ °C}$; note 1 | – | – | 32 | mW |
| h_{FE} | DC current gain | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_j = 25\text{ °C}$ | 50 | 80 | 200 | |
| f_T | transition frequency | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| F | noise figure | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.8 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 8 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 5 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 6.5 | mA |
| P_{tot} | total power dissipation | up to $T_s = 170\text{ °C}$; note 1 | – | 32 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 5 GHz wideband transistor

BFS25A

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 170\text{ °C}$; note 1 | 190 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$, unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 5\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$ | 50 | 80 | 200 | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 1\text{ V}$; $f = 1\text{ MHz}$ | – | 0.3 | 0.45 | pF |
| f_T | transition frequency | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 13 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.8 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 2 | – | dB |

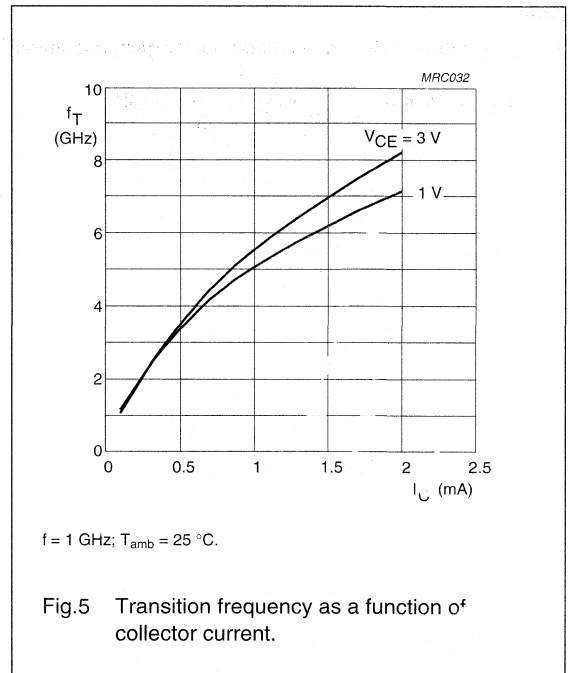
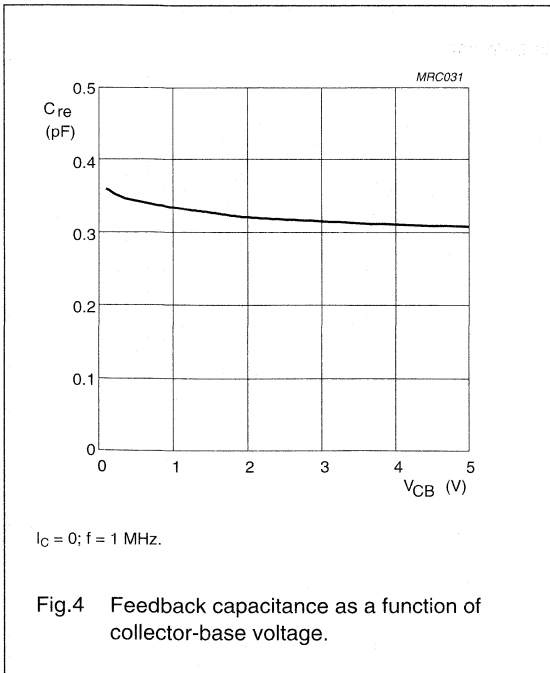
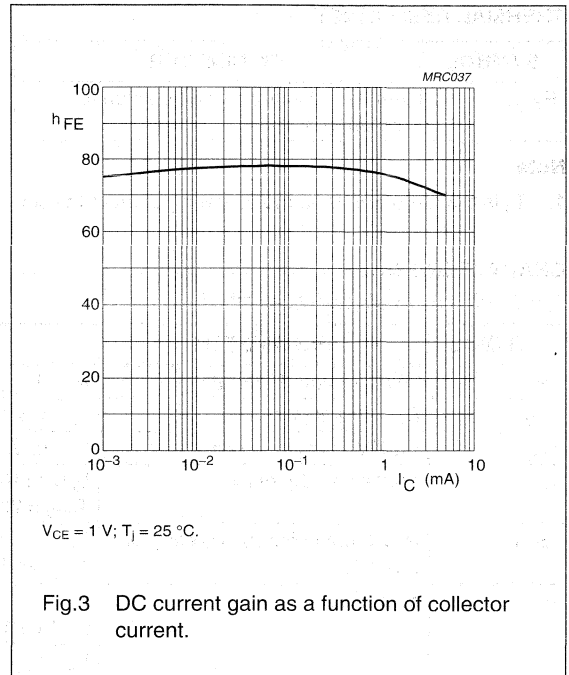
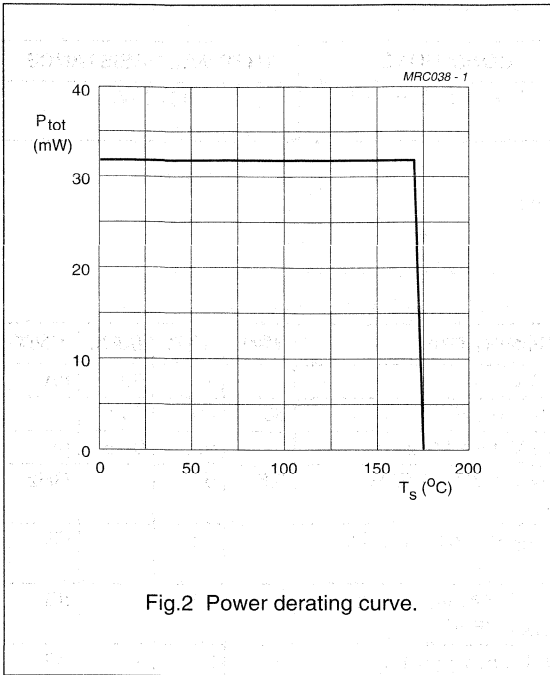
Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

NPN 5 GHz wideband transistor

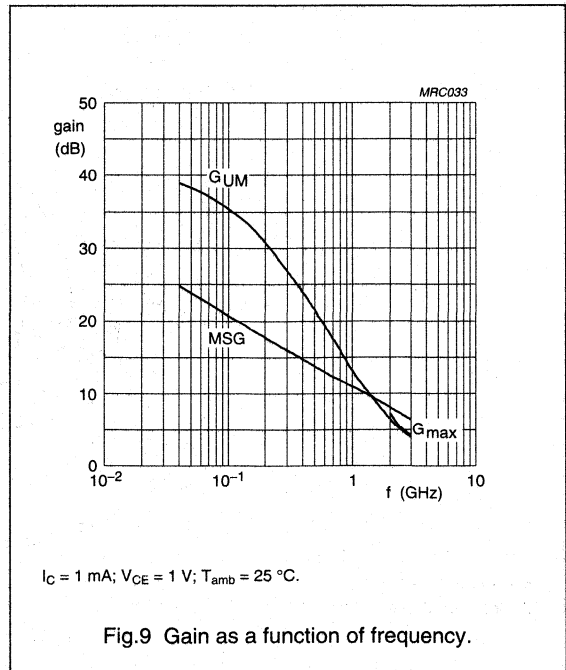
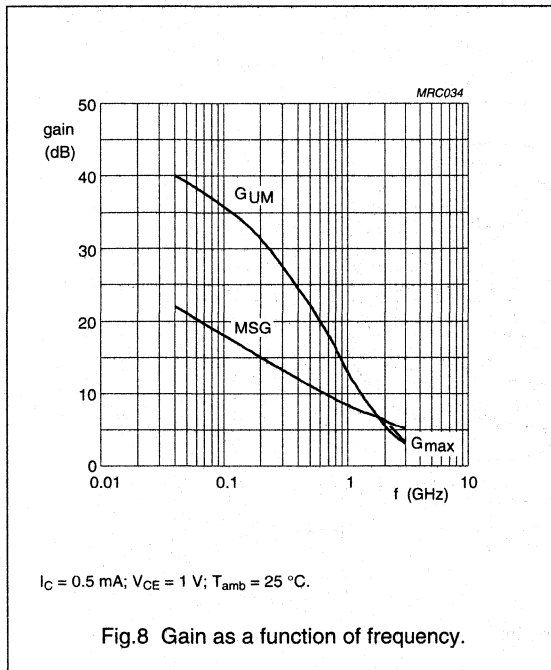
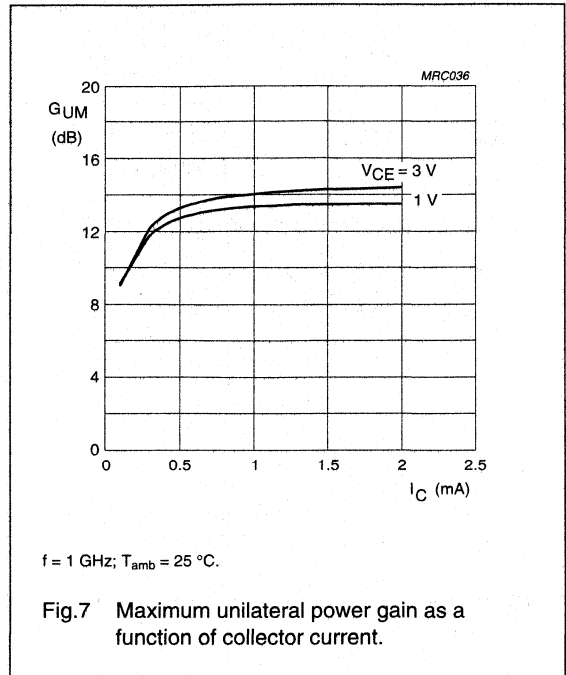
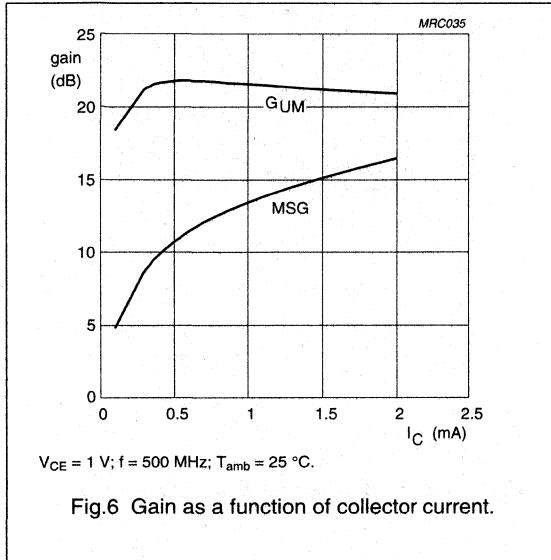
BFS25A



NPN 5 GHz wideband transistor

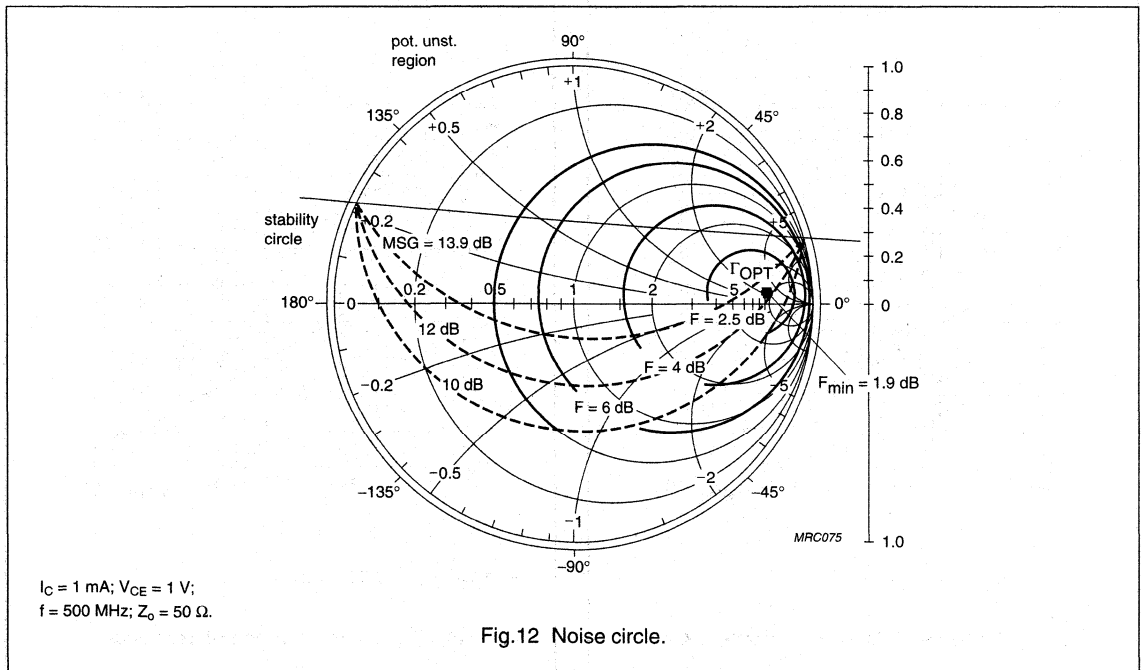
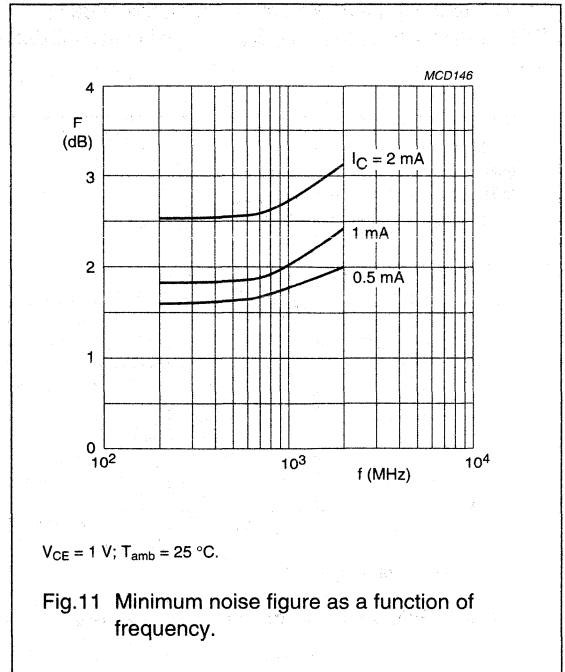
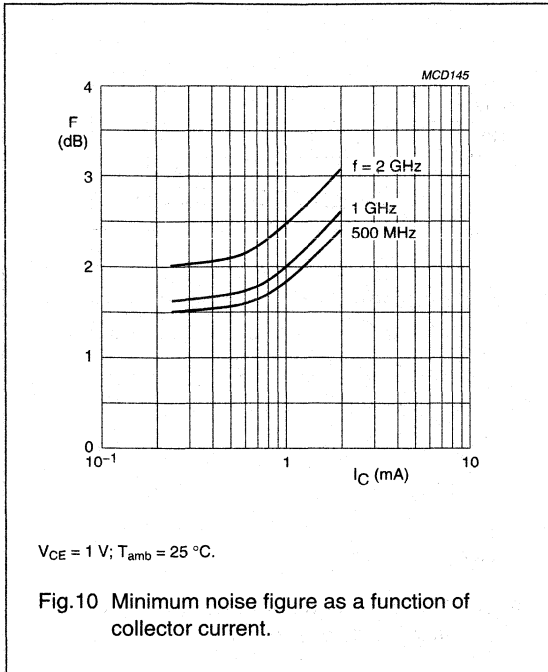
BFS25A

In Figs 7 to 9, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



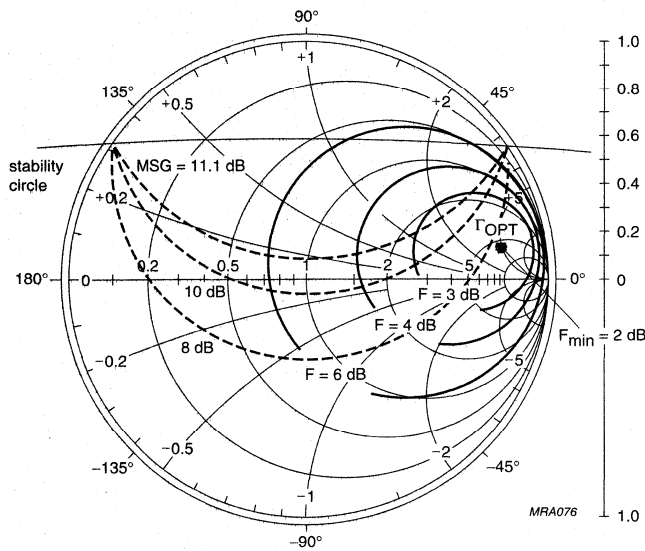
NPN 5 GHz wideband transistor

BFS25A



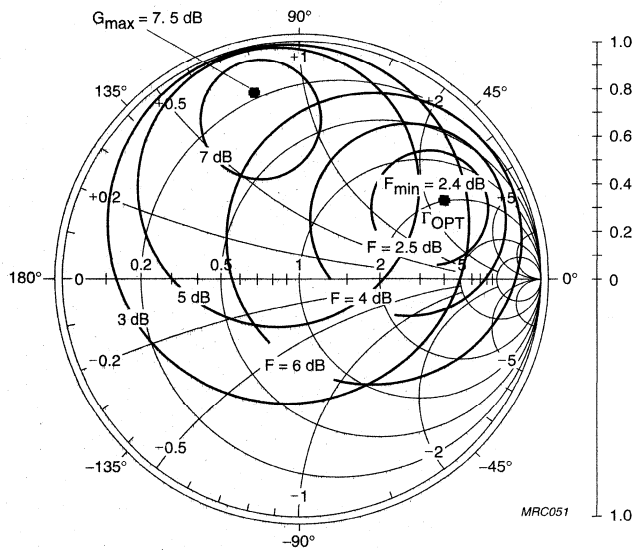
NPN 5 GHz wideband transistor

BFS25A



$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V};$
 $f = 1 \text{ GHz}; Z_0 = 50 \Omega.$

Fig.13 Noise circle.

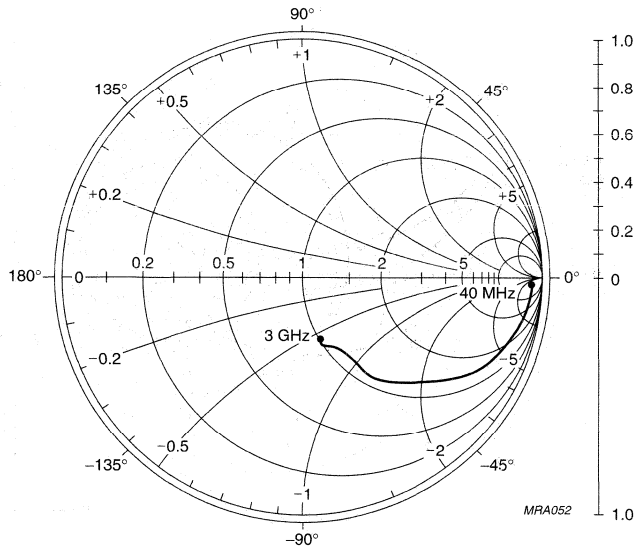


$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V};$
 $f = 2 \text{ GHz}; Z_0 = 50 \Omega.$

Fig.14 Noise circle.

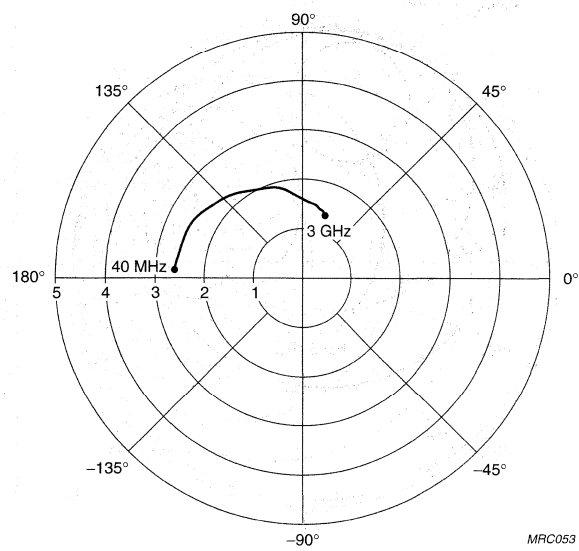
NPN 5 GHz wideband transistor

BFS25A



$I_C = 1 \text{ mA}$; $V_{CE} = 1 \text{ V}$;
 $Z_0 = 50 \Omega$.

Fig.15 Common emitter input reflection coefficient (S_{11}).

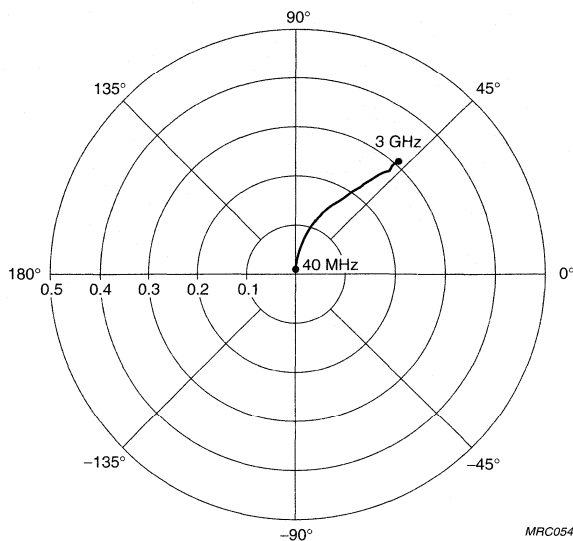


$I_C = 1 \text{ mA}$; $V_{CE} = 1 \text{ V}$.

Fig.16 Common emitter forward transmission coefficient (S_{21}).

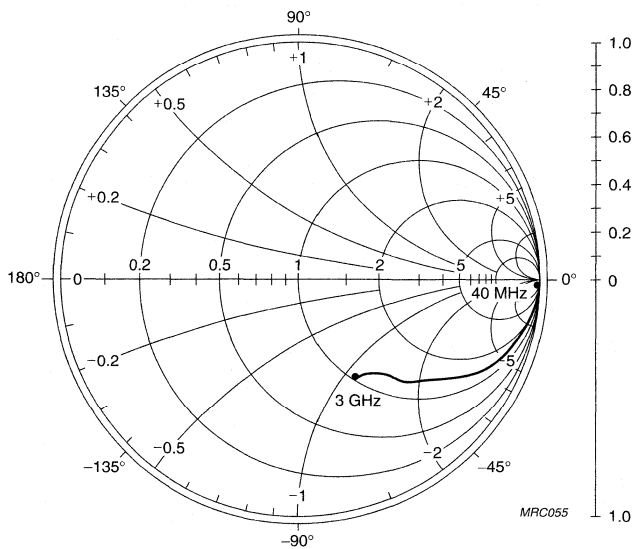
NPN 5 GHz wideband transistor

BFS25A



$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}.$

Fig.17 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V};$
 $Z_o = 50 \Omega.$

Fig.18 Common emitter output reflection coefficient (S_{22}).

NPN 9 GHz wideband transistor

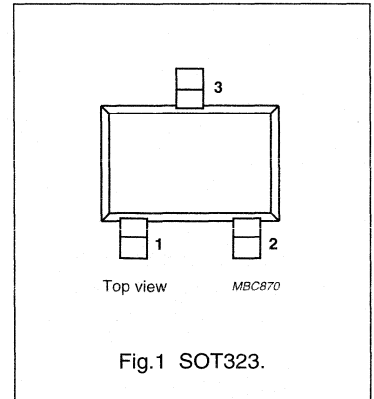
BFS505

FEATURES

- Low current consumption
- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability
- SOT323 envelope.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: N0 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



DESCRIPTION

NPN transistor in a plastic SOT323 envelope.

It is intended for low power amplifiers, oscillators and mixers particularly in RF portable communication equipment (cellular phones, cordless phones, pagers) up to 2 GHz.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CB0} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | DC collector current | | – | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 147\text{ °C}$; note 1 | – | – | 150 | mW |
| h_{FE} | DC current gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_j = 25\text{ °C}$ | 60 | 120 | 250 | |
| f_T | transition frequency | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 17 | – | dB |
| F | noise figure | $I_C = 1.25\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.2 | 1.7 | dB |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFS505

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 18 | mA |
| P_{tot} | total power dissipation | up to $T_s = 147\text{ °C}$; note 1 | – | 150 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 147\text{ °C}$; note 1 | 190 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFS505

CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$, unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|---|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 6\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $I_C = I_e = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| C_c | collector capacitance | $I_E = I_e = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.3 | – | pF |
| f_T | transition frequency | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 17 | – | dB |
| | | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 10 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 13 | 14 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 1.25\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1.2 | 1.7 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 1.25\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 1.9 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 4 | – | dBm |
| ITO | third order intercept point | note 2 | – | 10 | – | dBm |

Notes

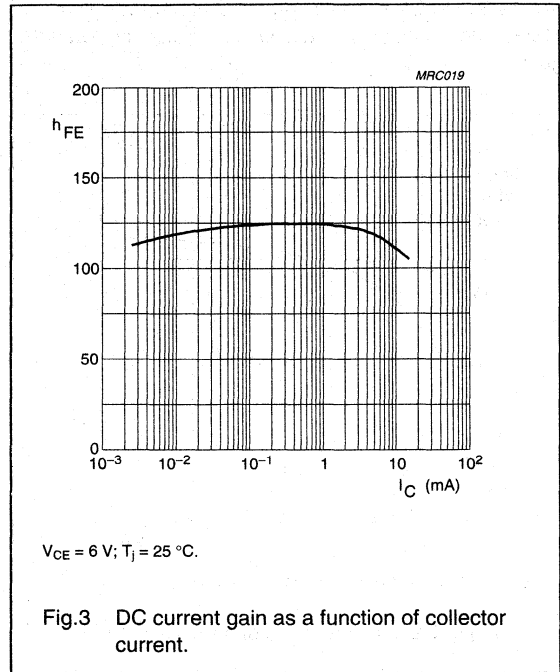
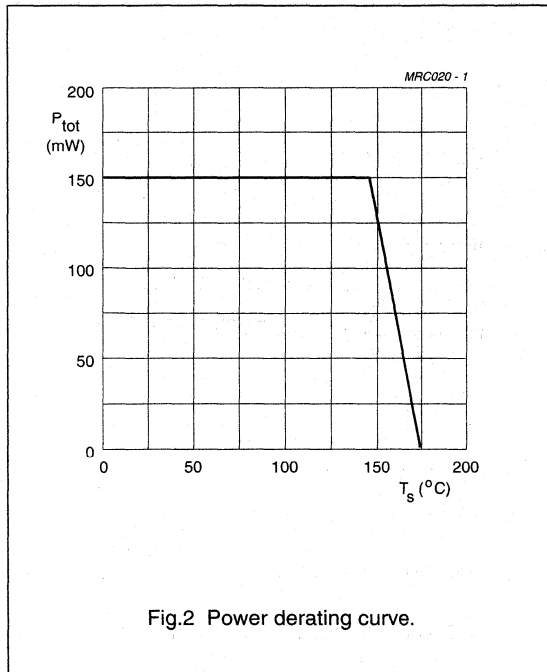
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \text{ dB.}$$

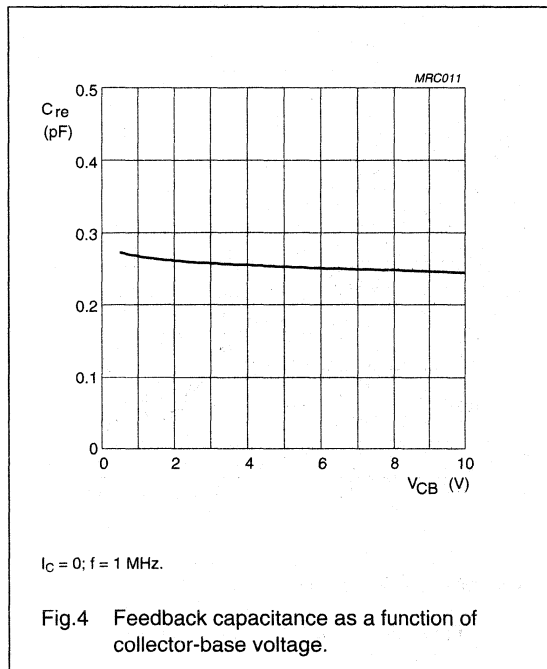
2. $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$;
 $f_p = 900\text{ MHz}$; $f_q = 902\text{ MHz}$; measured at $f_{(2p-q)} = 898\text{ MHz}$ and at $f_{(2p-q)} = 904\text{ MHz}$.

NPN 9 GHz wideband transistor

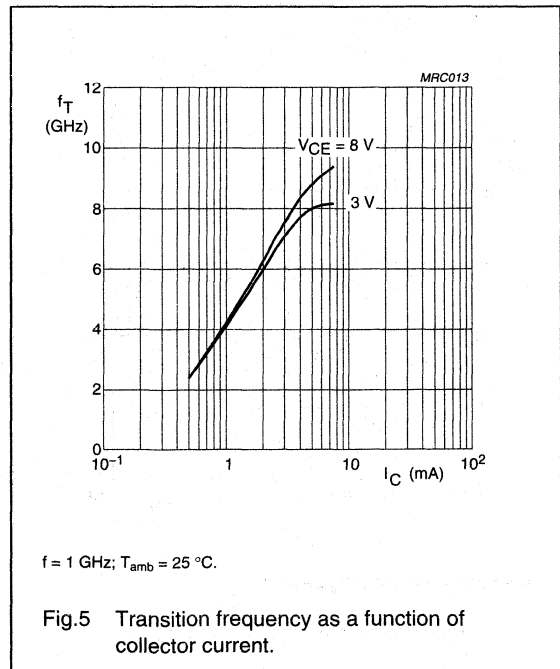
BFS505



$V_{CE} = 6 \text{ V}; T_J = 25 \text{ }^\circ\text{C}.$



$I_C = 0; f = 1 \text{ MHz}.$

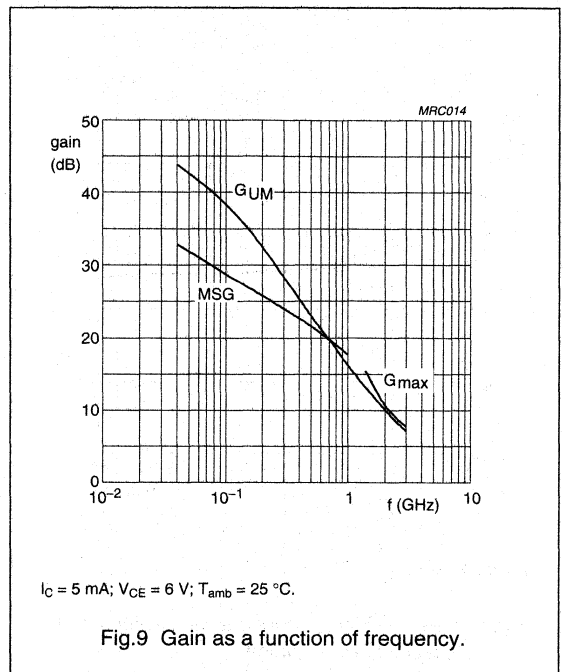
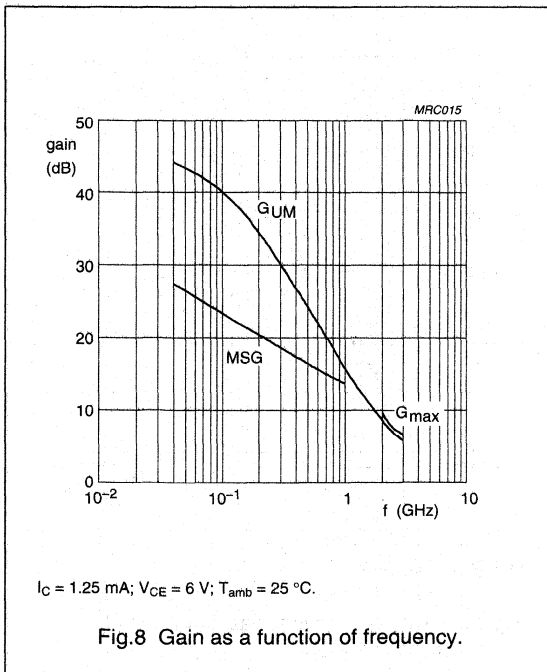
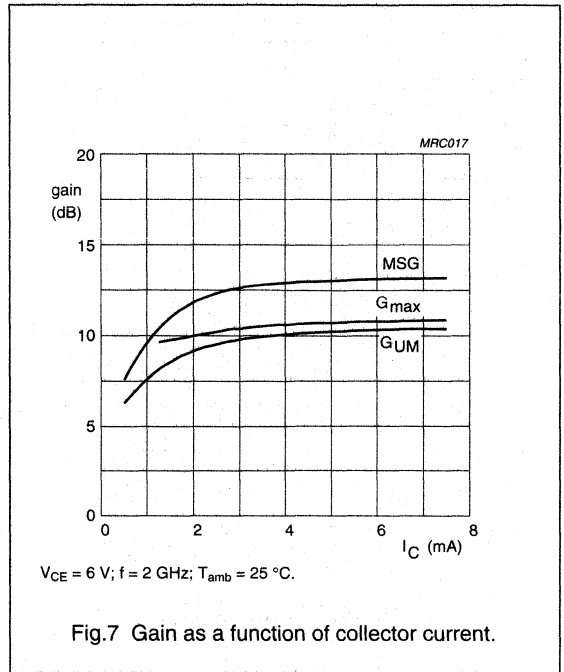
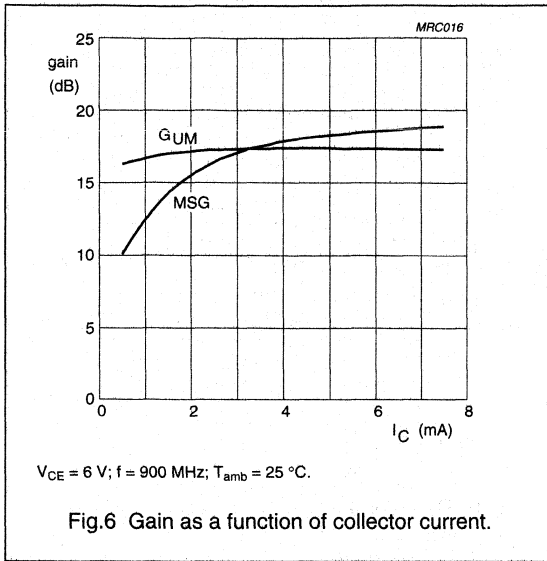


$f = 1 \text{ GHz}; T_{amb} = 25 \text{ }^\circ\text{C}.$

NPN 9 GHz wideband transistor

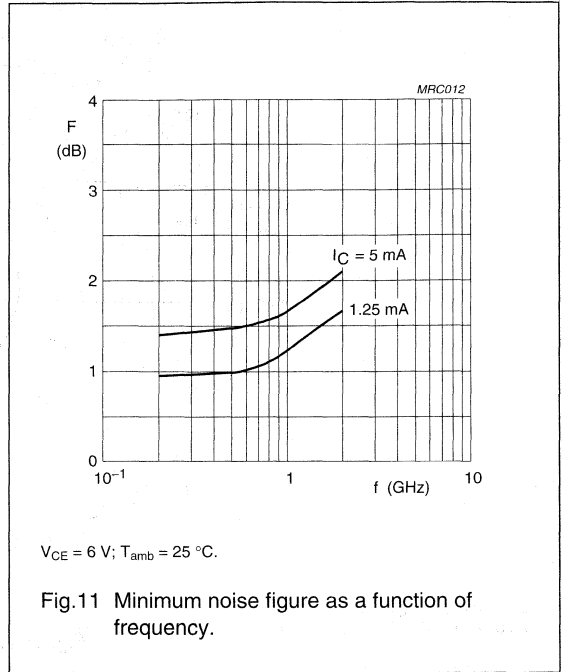
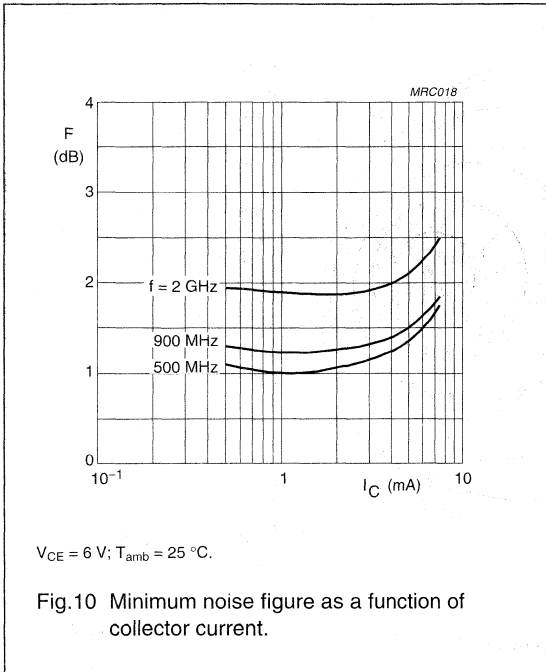
BFS505

In Figs 6 to 9, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



NPN 9 GHz wideband transistor

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NPN 9 GHz wideband transistor

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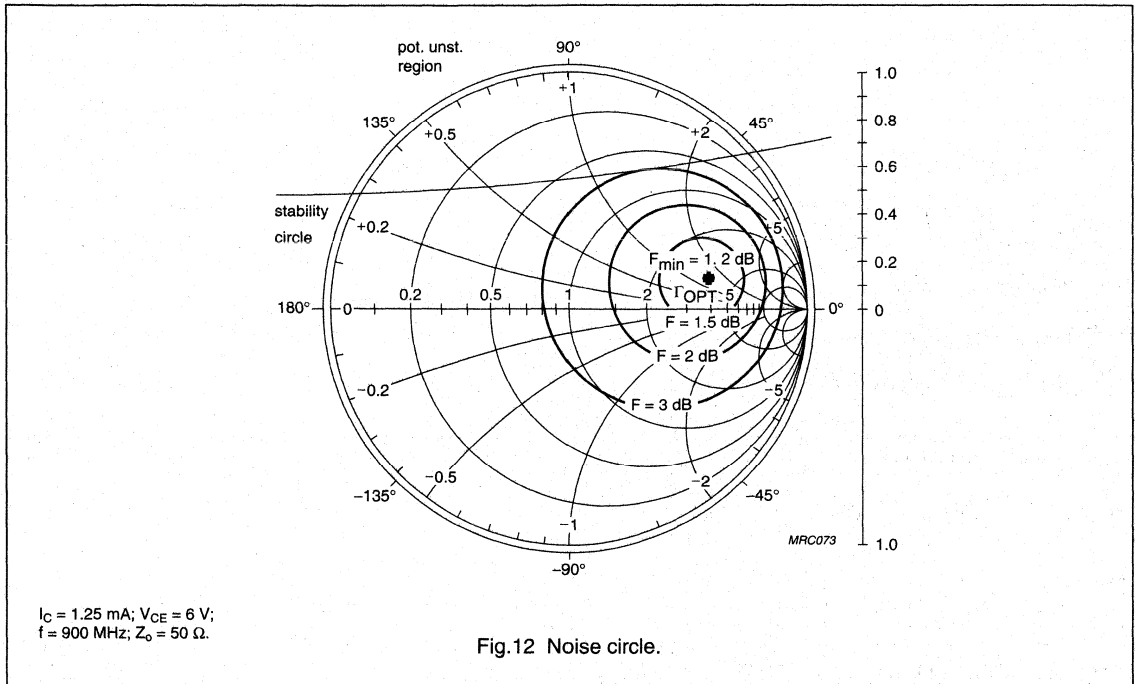


Fig.12 Noise circle.

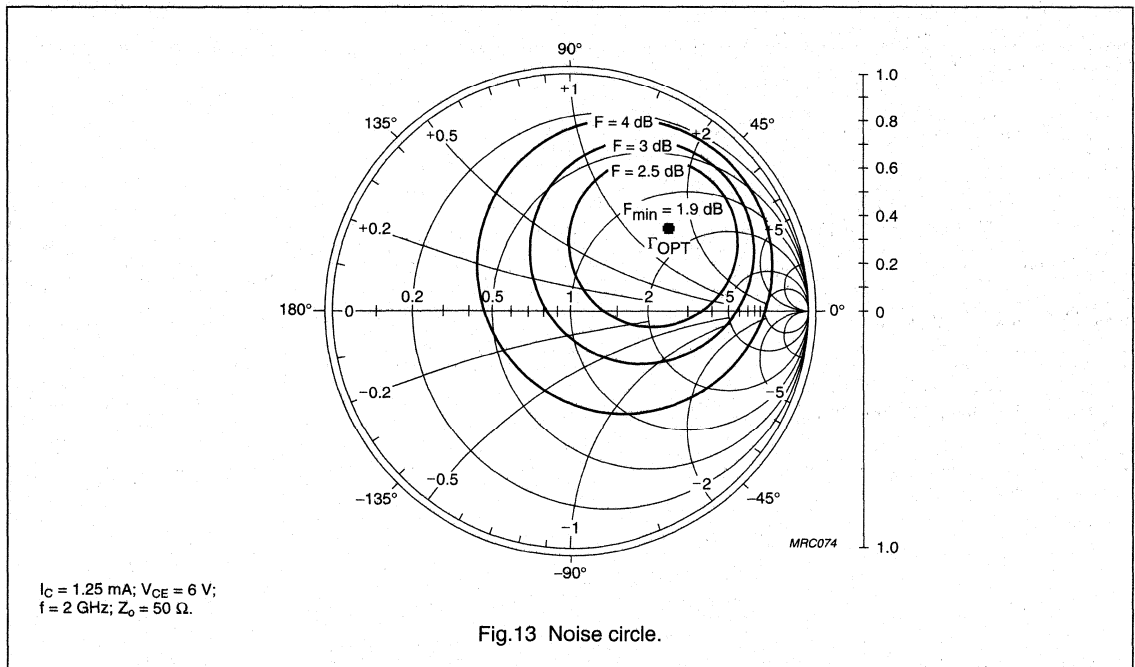
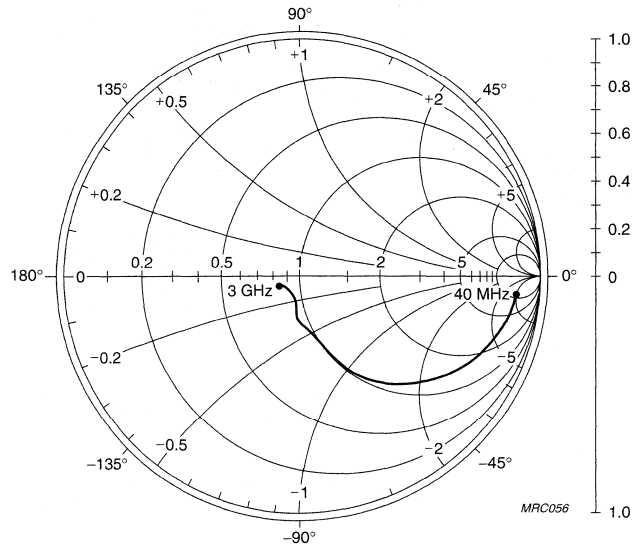


Fig.13 Noise circle.

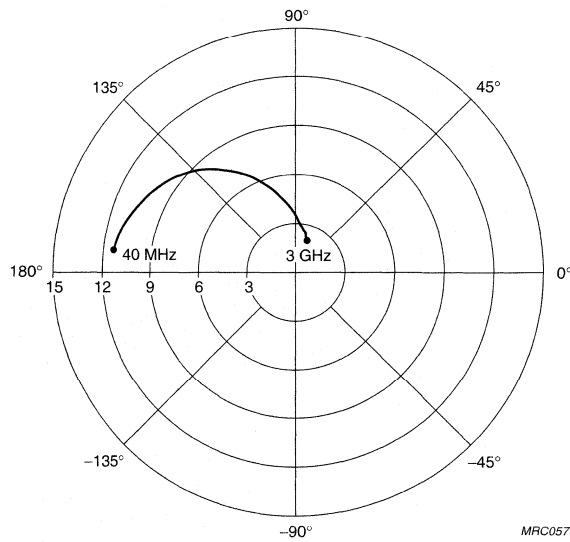
NPN 9 GHz wideband transistor

BFS505



$I_C = 5 \text{ mA}; V_{CE} = 6 \text{ V};$
 $Z_0 = 50 \Omega.$

Fig.14 Common emitter input reflection coefficient (S_{11}).

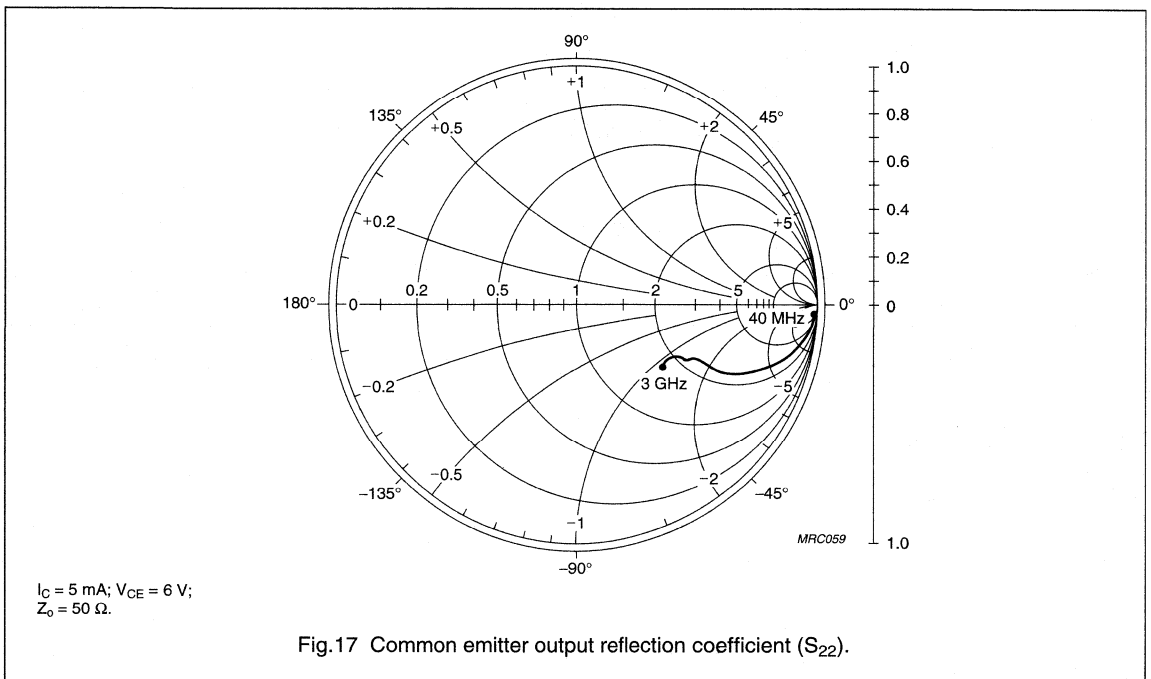
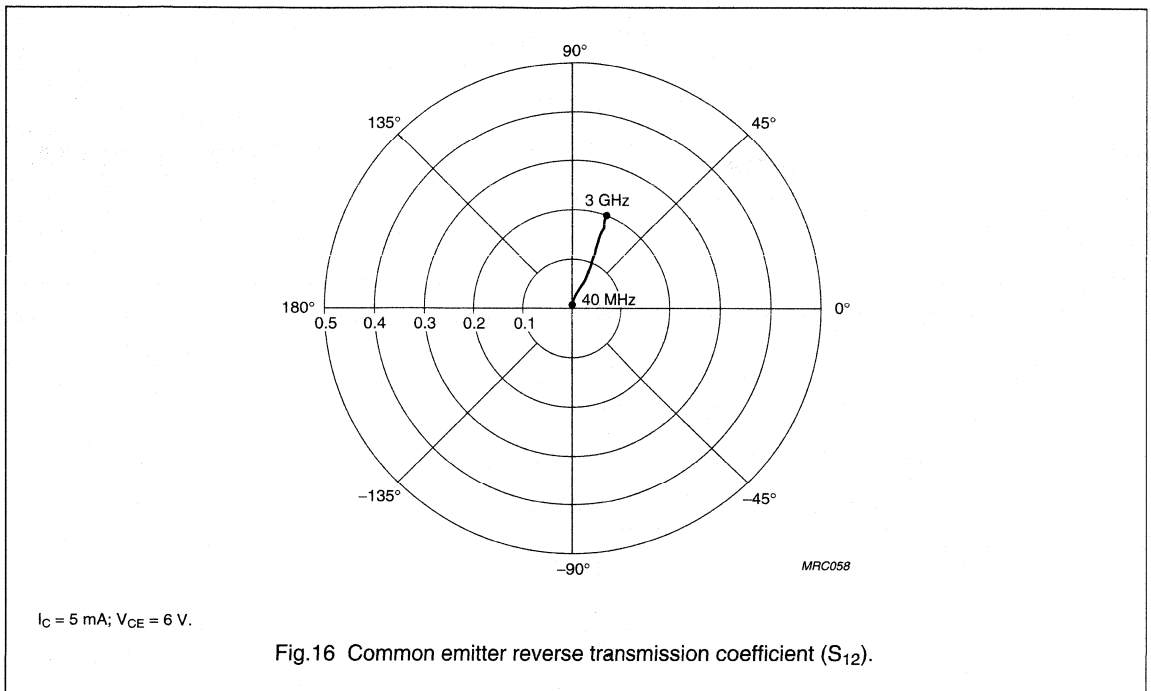


$I_C = 5 \text{ mA}; V_{CE} = 6 \text{ V}.$

Fig.15 Common emitter forward transmission coefficient (S_{21}).

NPN 9 GHz wideband transistor

BFS505



NPN 9 GHz wideband transistor

BFS520

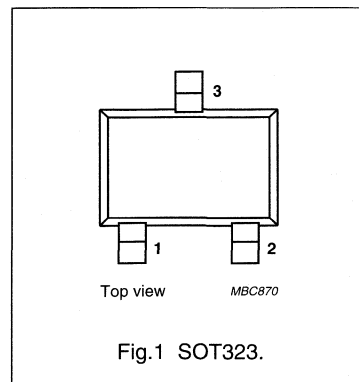
FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability
- SOT323 envelope.

It is intended for wideband applications such as satellite TV tuners, cellular phones, cordless phones, pagers etc., with signal frequencies up to 2 GHz.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: N2 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



DESCRIPTION

NPN transistor in a plastic SOT323 envelope.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CB0} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | – | 15 | V |
| I_C | DC collector current | | – | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ °C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $T_j = 25\text{ °C}$ | 60 | 120 | 250 | |
| f_T | transition frequency | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| F | noise figure | $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.1 | 1.6 | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--------------------------------------|------|------|------|
| V_{CB0} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 70 | mA |
| P_{tot} | total power dissipation | up to $T_s = 118\text{ °C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFS520

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 118\text{ °C}$; note 1 | 190 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$, unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CE} = 6\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $I_C = I_e = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1 | – | pF |
| C_c | collector capacitance | $I_E = I_e = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 6\text{ V}$; $f = 1\text{ MHz}$ | – | 0.4 | – | pF |
| f_T | transition frequency | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15 | – | dB |
| | | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 13 | 14 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.1 | 1.6 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.6 | 2.1 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 5\text{ mA}$; $V_{CE} = 6\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.9 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 17 | – | dBm |
| ITO | third order intercept point | note 2 | – | 26 | – | dBm |

Notes

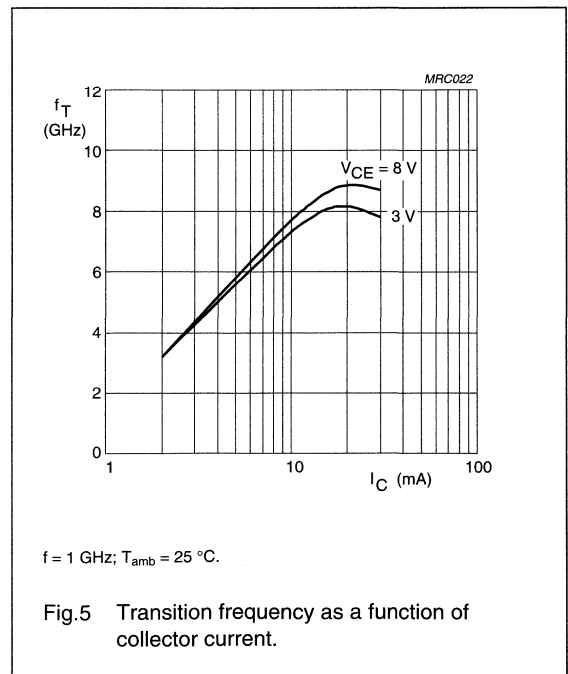
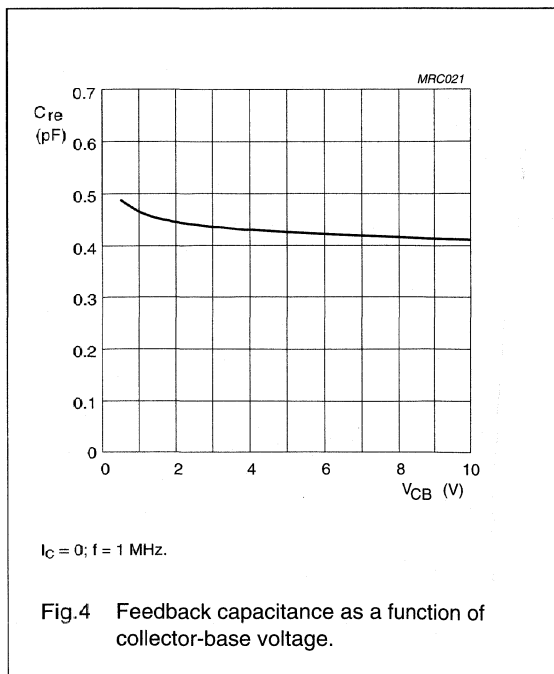
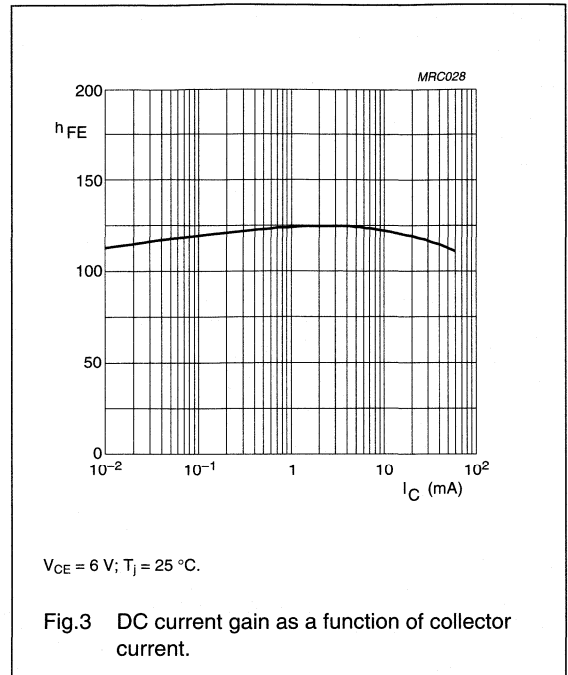
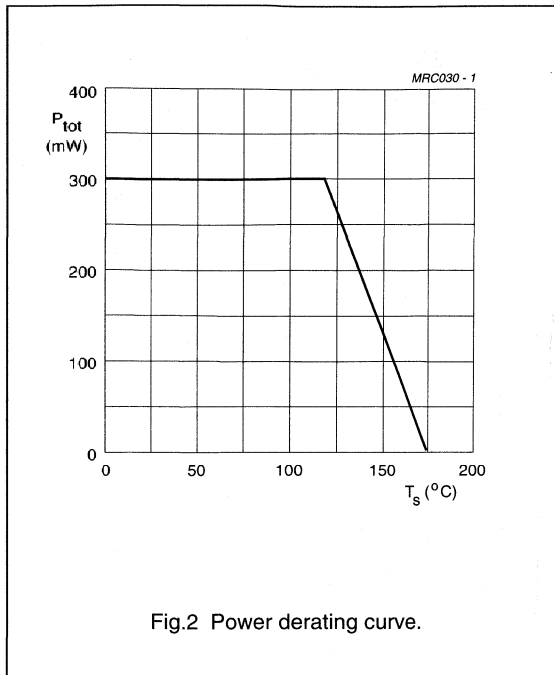
- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

- $I_C = 20\text{ mA}$; $V_{CE} = 6\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$;
 $f_p = 900\text{ MHz}$; $f_q = 902\text{ MHz}$; measured at $f_{(2p-q)} = 898\text{ MHz}$ and at $f_{(2q-p)} = 904\text{ MHz}$.

NPN 9 GHz wideband transistor

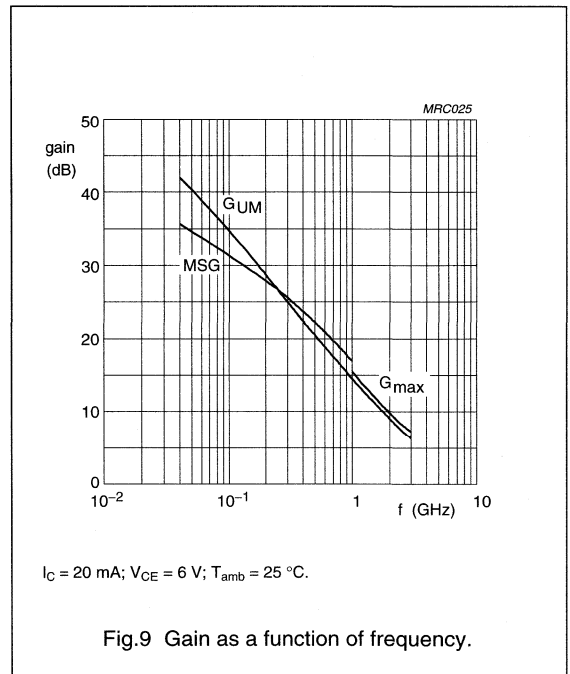
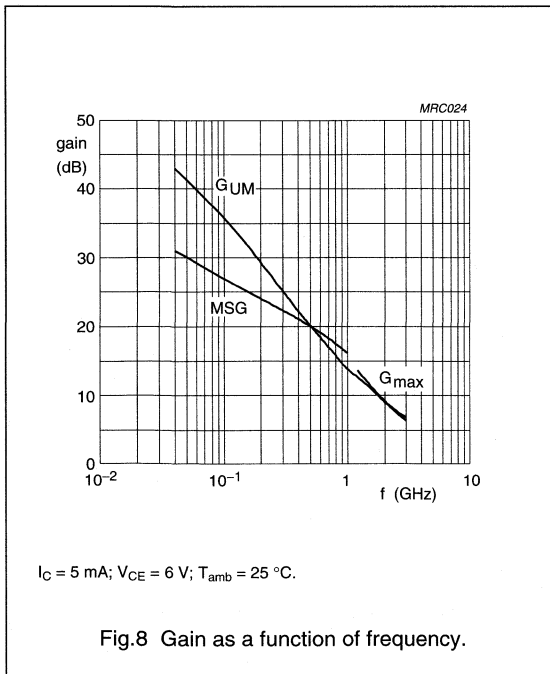
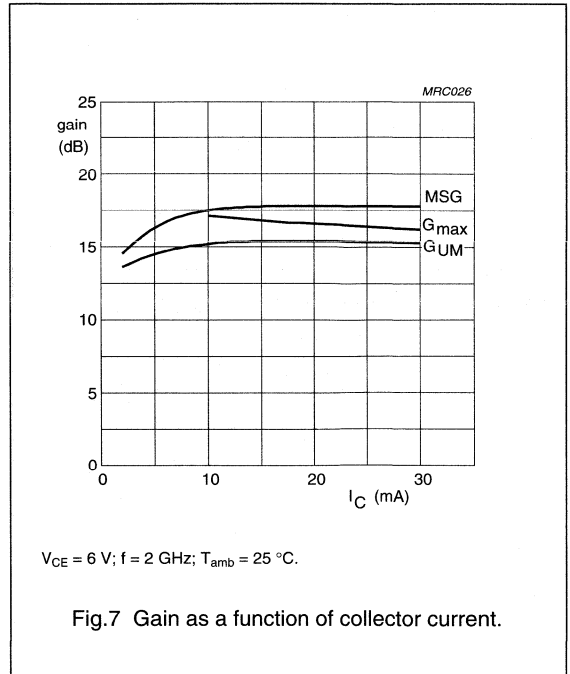
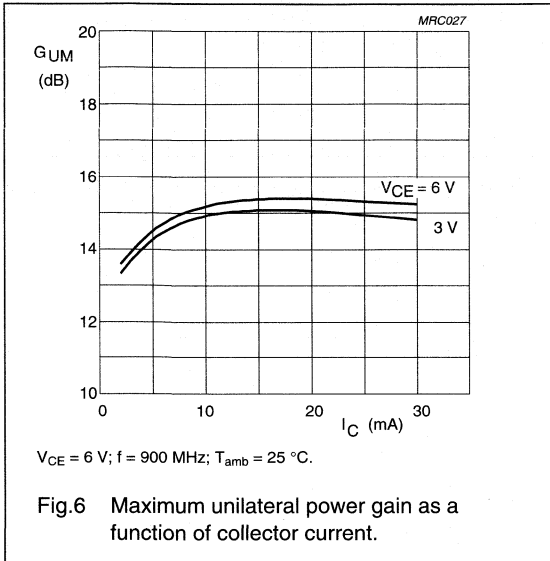
BFS520



NPN 9 GHz wideband transistor

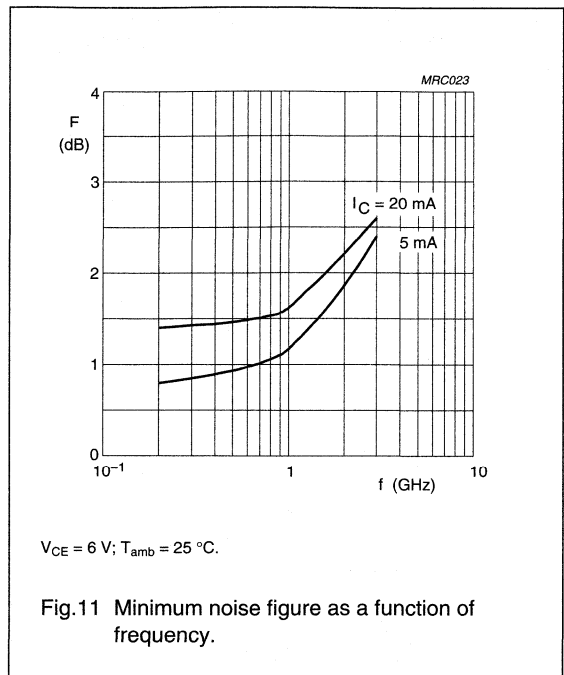
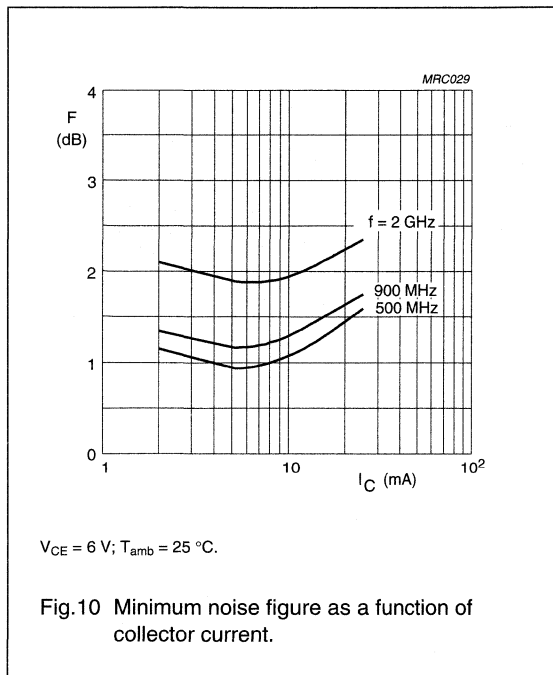
BFS520

In Figs 6 to 9, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



NPN 9 GHz wideband transistor

BFS520



NPN 9 GHz wideband transistor

BFS520

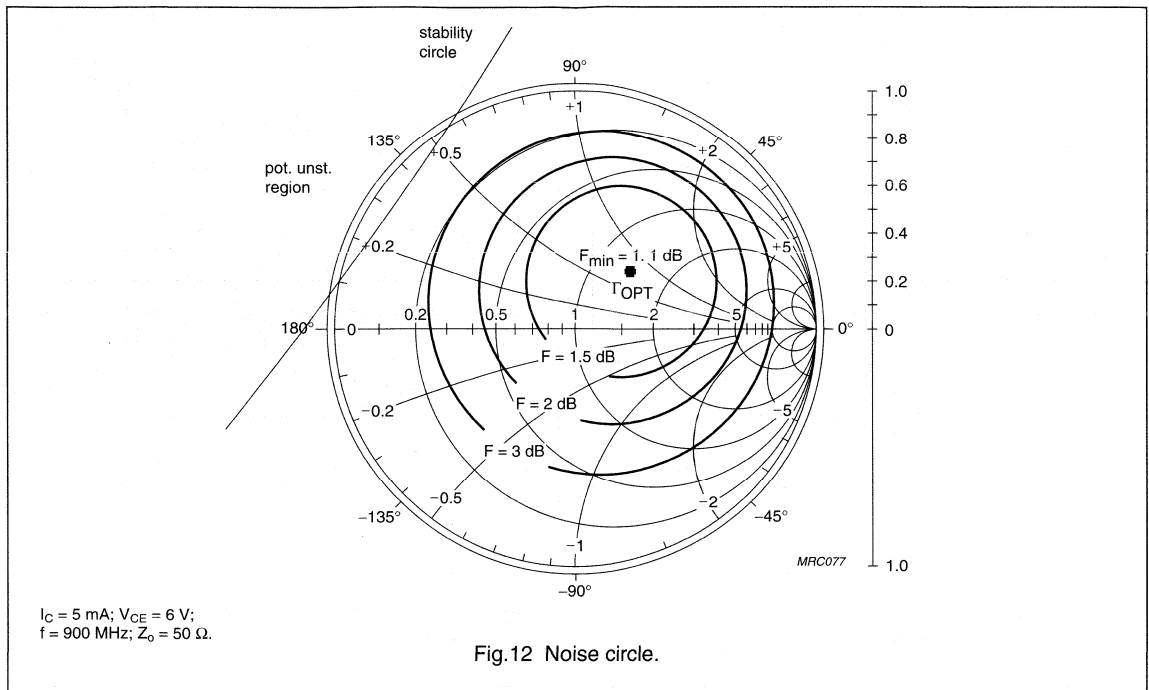


Fig.12 Noise circle.

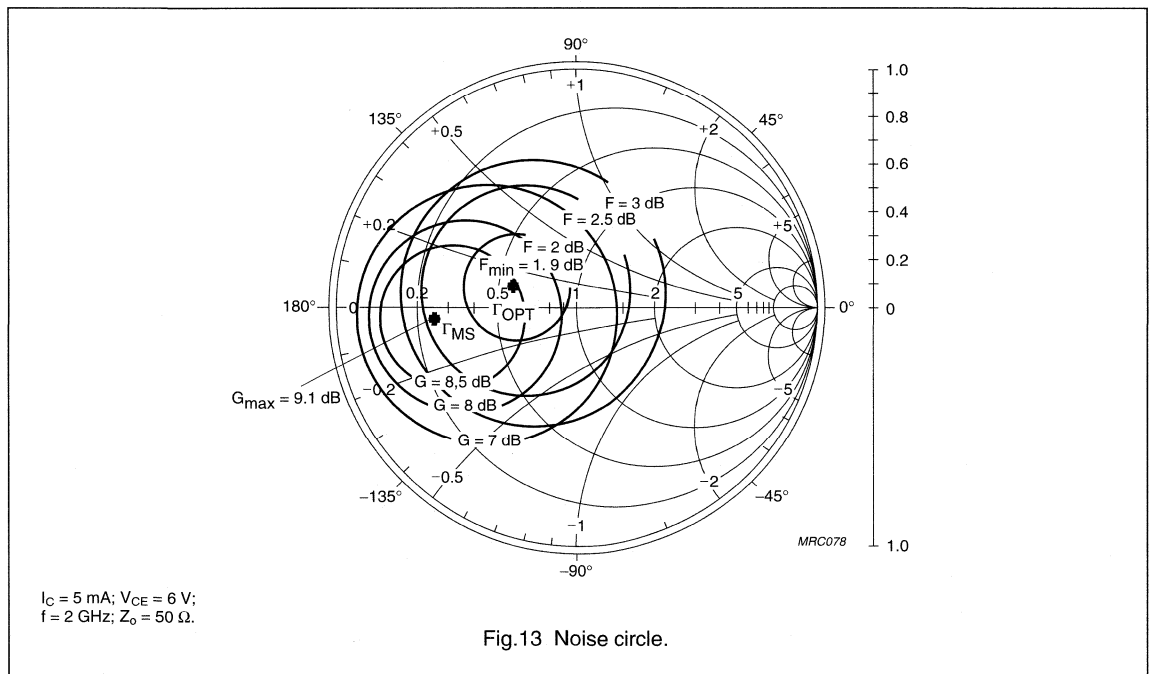
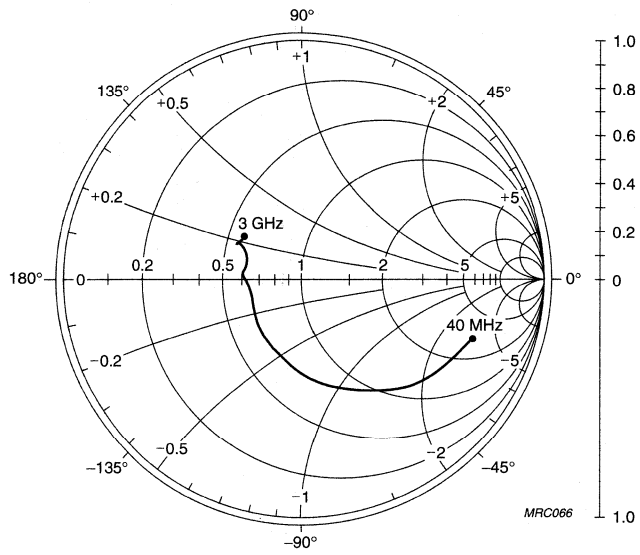


Fig.13 Noise circle.

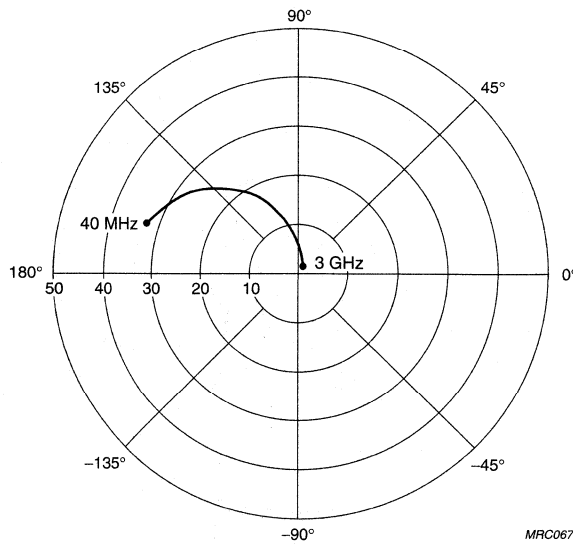
NPN 9 GHz wideband transistor

BFS520



$I_C = 20 \text{ mA}; V_{CE} = 6 \text{ V};$
 $Z_0 = 50 \Omega.$

Fig.14 Common emitter input reflection coefficient (S_{11}).

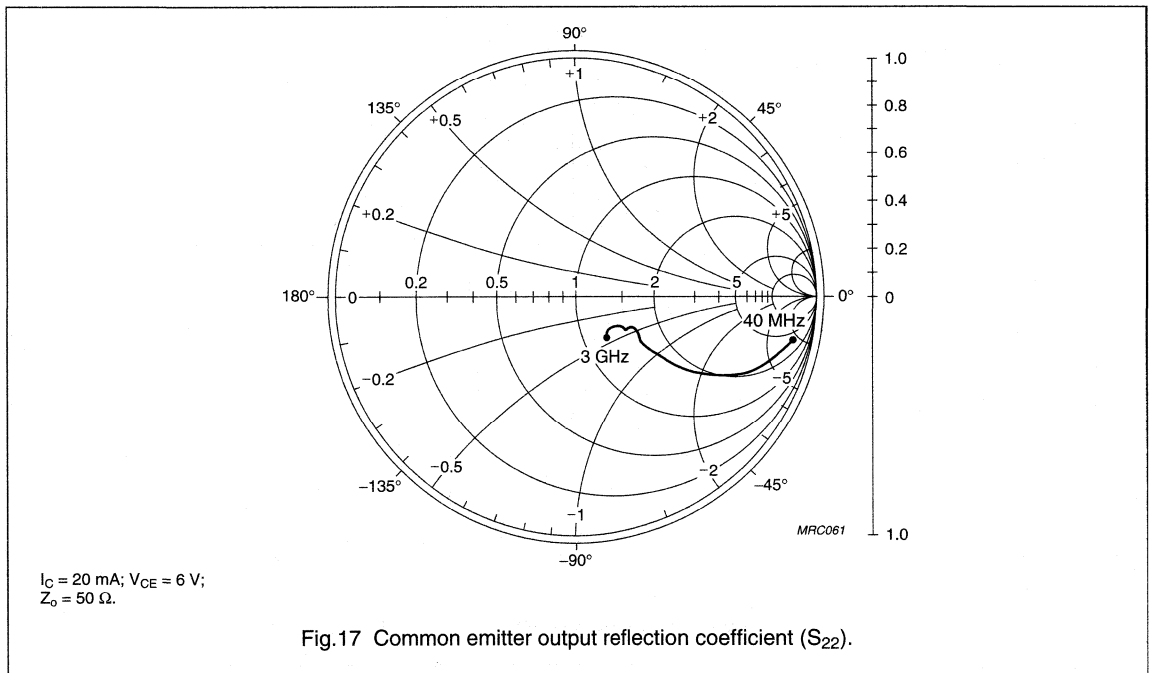
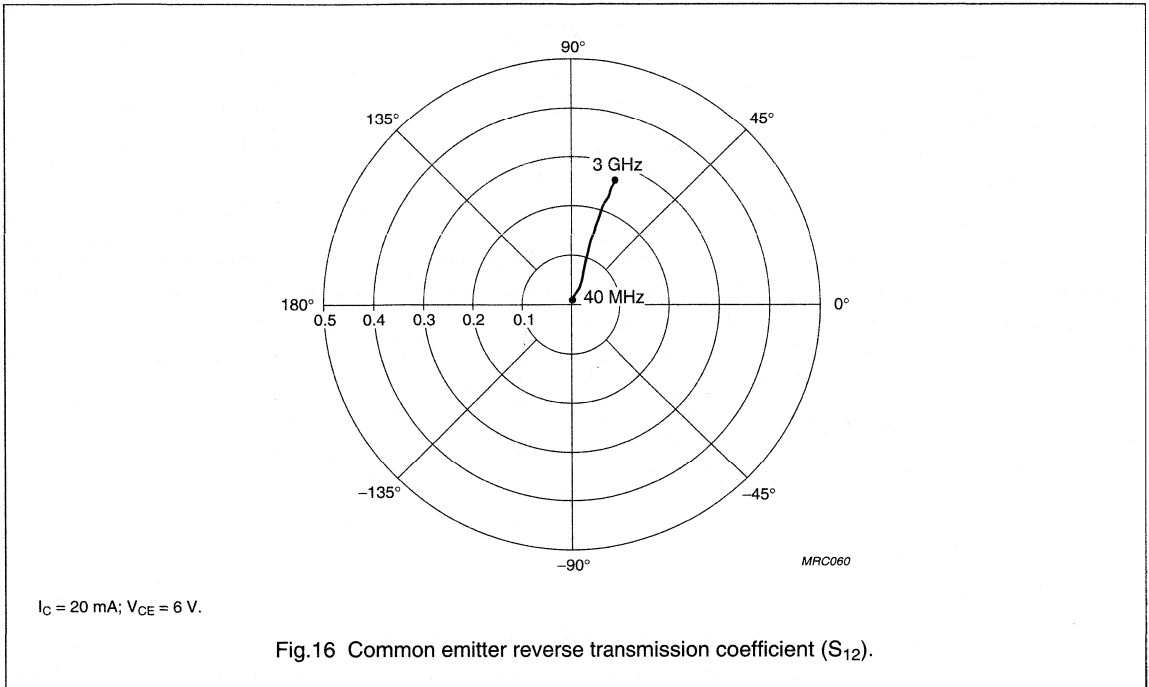


$I_C = 20 \text{ mA}; V_{CE} = 6 \text{ V}.$

Fig.15 Common emitter forward transmission coefficient (S_{21}).

NPN 9 GHz wideband transistor

BFS520



NPN 9 GHz wideband transistor

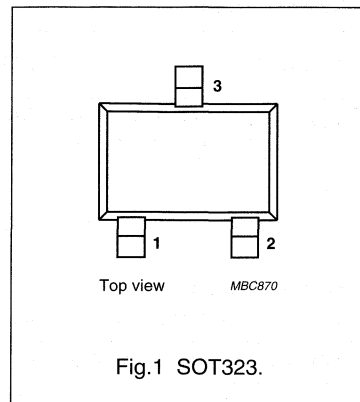
BFS540

FEATURES

- High power gain
- Low noise figure
- High transition frequency
- Gold metallization ensures excellent reliability
- SOT323 envelope.

PINNING

| PIN | DESCRIPTION |
|----------|-------------|
| Code: N4 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



DESCRIPTION

NPN transistor in a plastic SOT323 envelope.

It is intended for RF wideband amplifier applications such as satellite TV systems and RF portable communication equipment with signal frequencies up to 2 GHz.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 15 | V |
| I_C | DC collector current | | – | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 80\text{ °C}$; note 1 | – | – | 500 | mW |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $T_j = 25\text{ °C}$ | 60 | 120 | 250 | |
| f_T | transition frequency | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 14 | – | dB |
| F | noise figure | $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.3 | 1.7 | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CES} | collector-emitter voltage | $R_{BE} = 0$ | – | 15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | DC collector current | | – | 120 | mA |
| P_{tot} | total power dissipation | up to $T_s = 80\text{ °C}$; note 1 | – | 500 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 9 GHz wideband transistor

BFS540

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|-------------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 80\text{ °C}$; note 1 | 190 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25\text{ °C}$, unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|--------------|--|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CE} = 8\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$ | 60 | 120 | 250 | |
| C_e | emitter capacitance | $I_C = I_C = 0$; $V_{EB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 2 | – | pF |
| C_c | collector capacitance | $I_E = I_e = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.9 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = 8\text{ V}$; $f = 1\text{ MHz}$ | – | 0.6 | – | pF |
| f_T | transition frequency | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 9 | – | GHz |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 14 | – | dB |
| | | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 8 | – | dB |
| $ S_{21} ^2$ | insertion power gain | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 12 | 13 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.3 | 1.8 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 1.9 | 2.4 | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = 10\text{ mA}$; $V_{CE} = 8\text{ V}$; $f = 2\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 2.1 | – | dB |
| P_{L1} | output power at 1 dB gain compression | $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 21 | – | dBm |
| ITO | third order intercept point | note 2 | – | 34 | – | dBm |

Notes

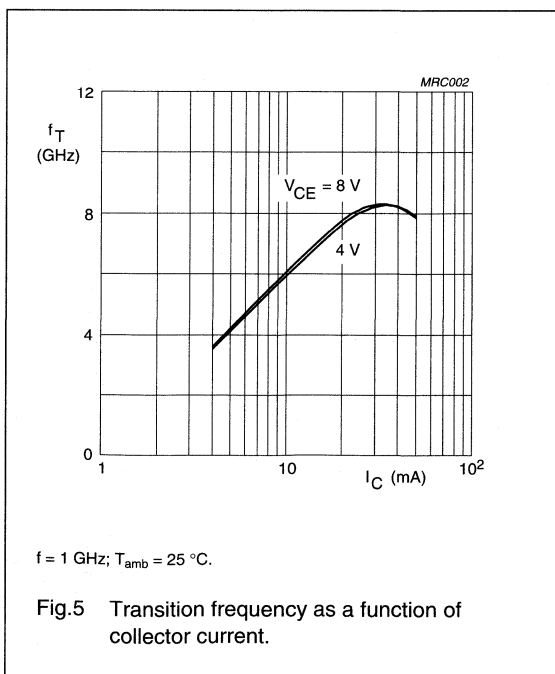
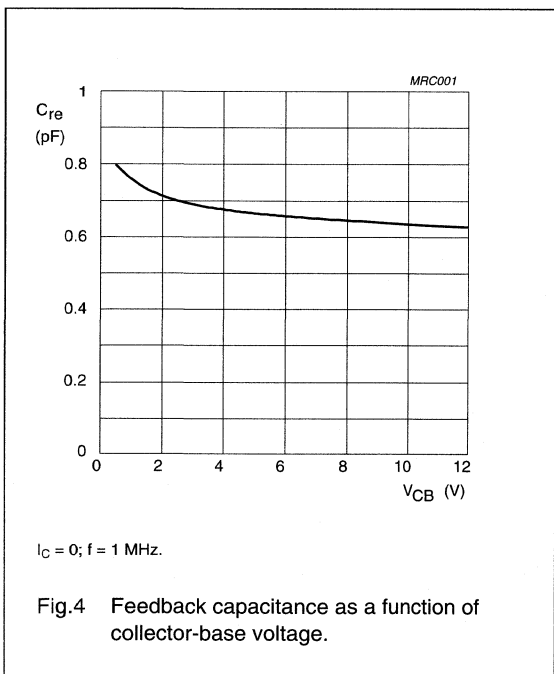
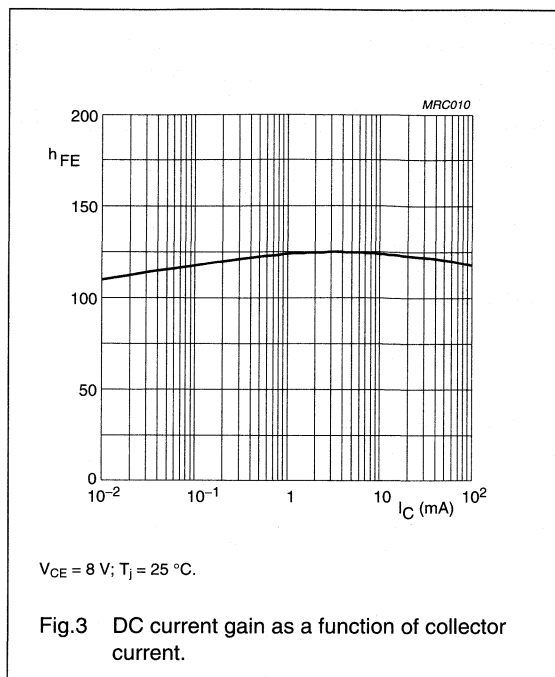
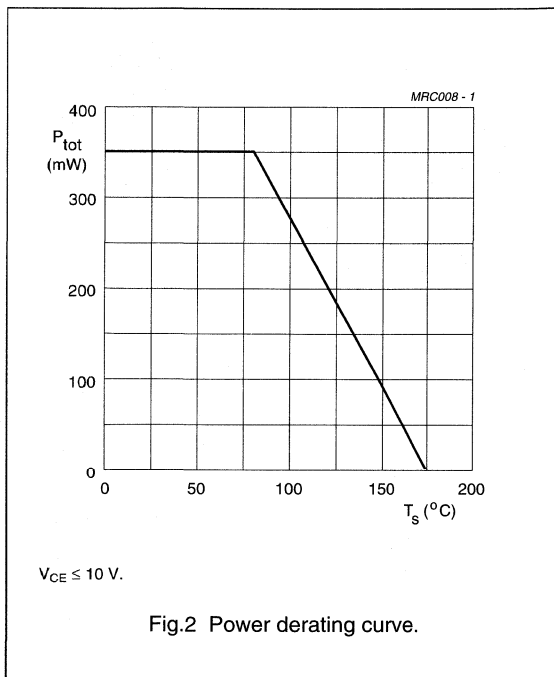
- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

- $I_C = 40\text{ mA}$; $V_{CE} = 8\text{ V}$; $R_L = 50\text{ }\Omega$; $f = 900\text{ MHz}$; $T_{amb} = 25\text{ °C}$;
 $f_p = 900\text{ MHz}$; $f_q = 902\text{ MHz}$; measured at $f_{(2p-q)} = 898\text{ MHz}$ and at $f_{(2q-p)} = 904\text{ MHz}$.

NPN 9 GHz wideband transistor

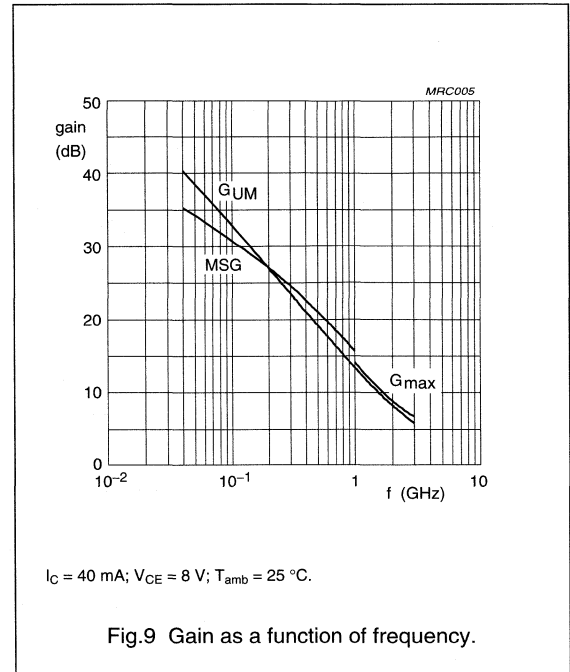
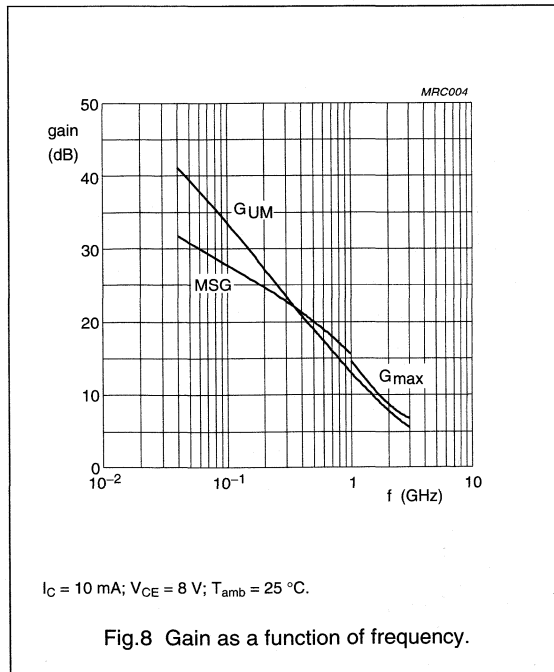
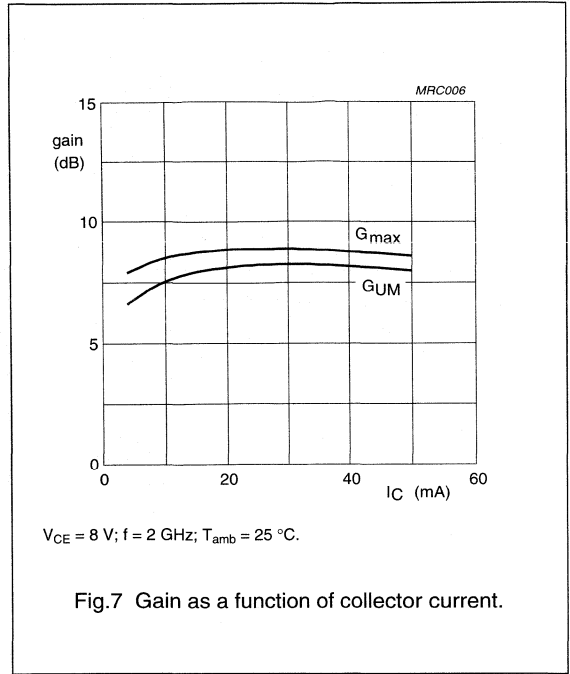
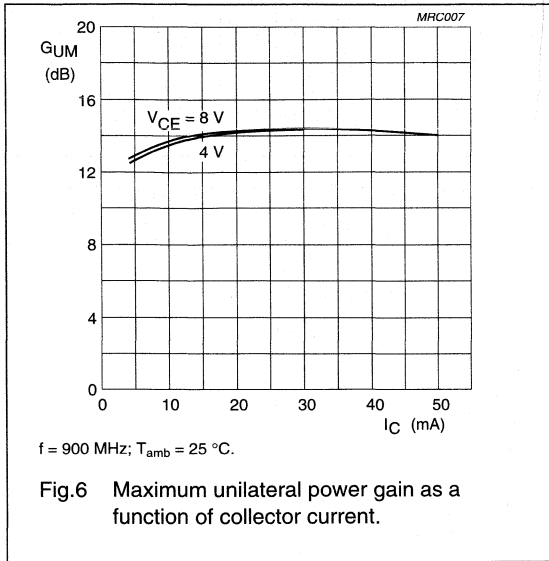
BFS540



NPN 9 GHz wideband transistor

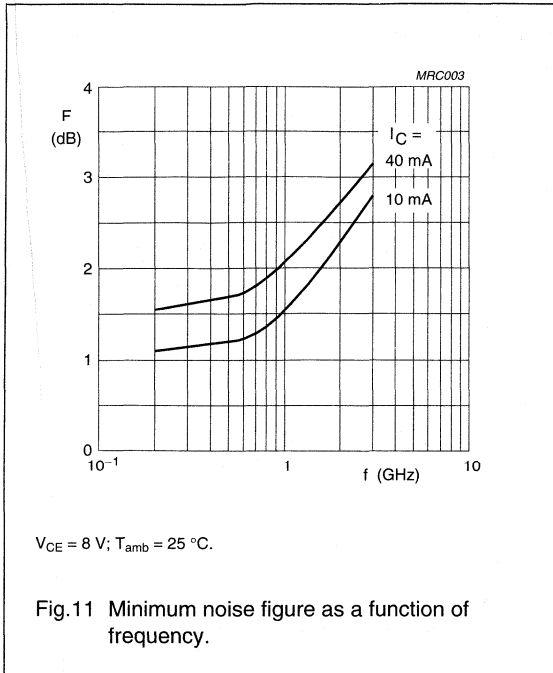
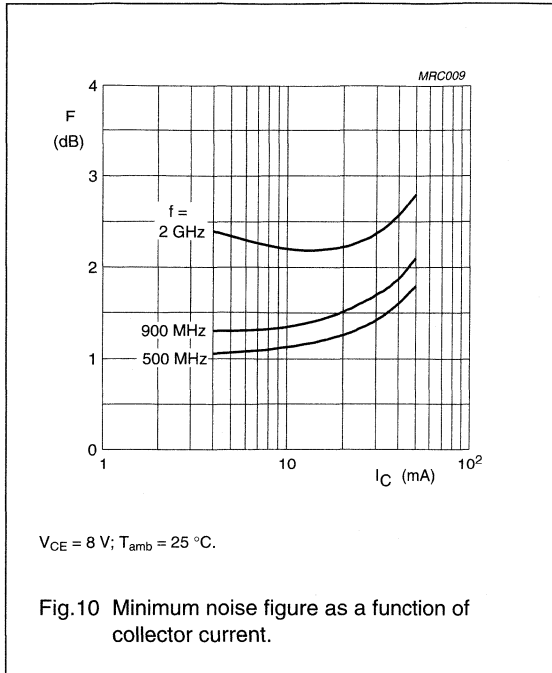
BFS540

In Figs 6 to 9, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



NPN 9 GHz wideband transistor

BFS540



NPN 9 GHz wideband transistor

BFS540

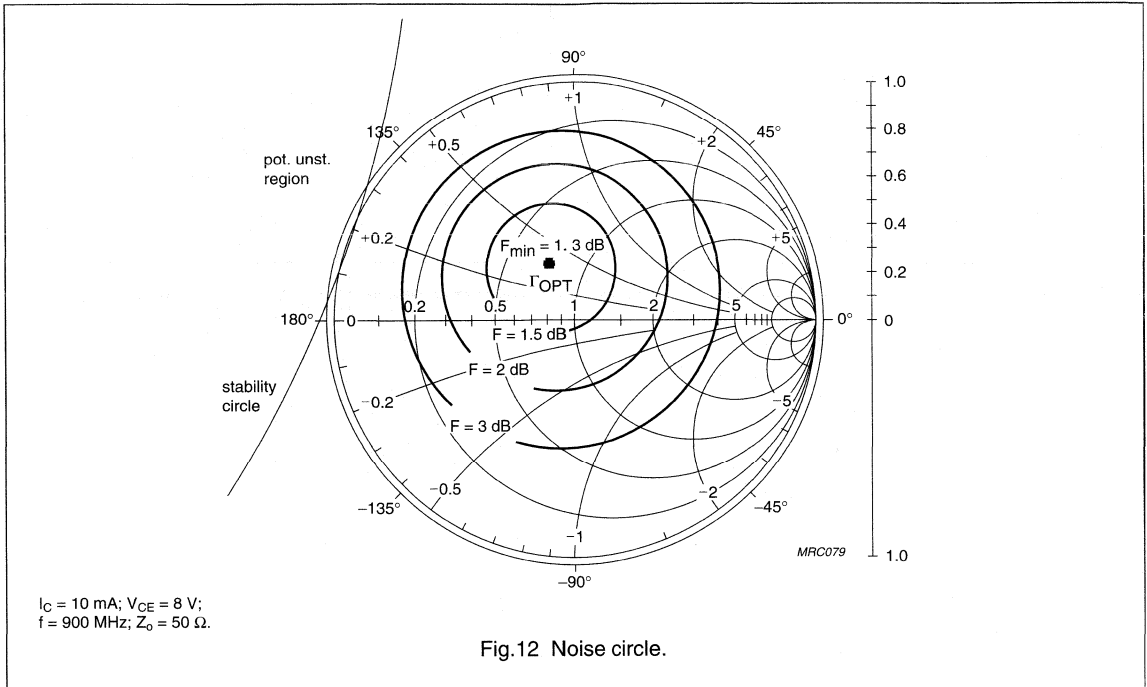


Fig.12 Noise circle.

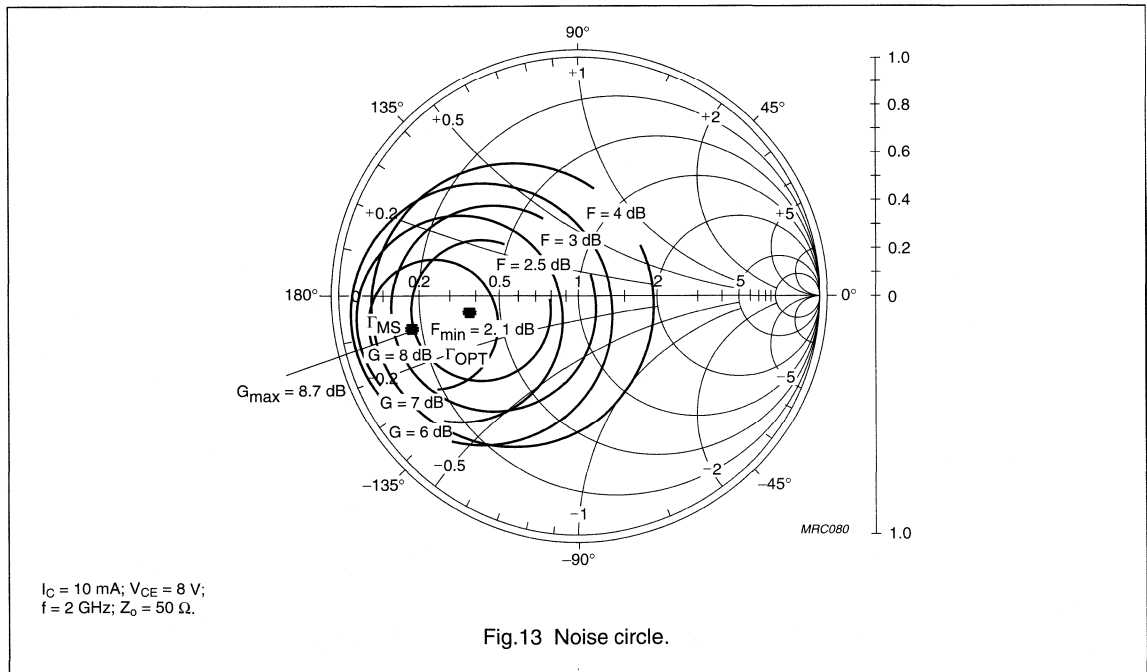
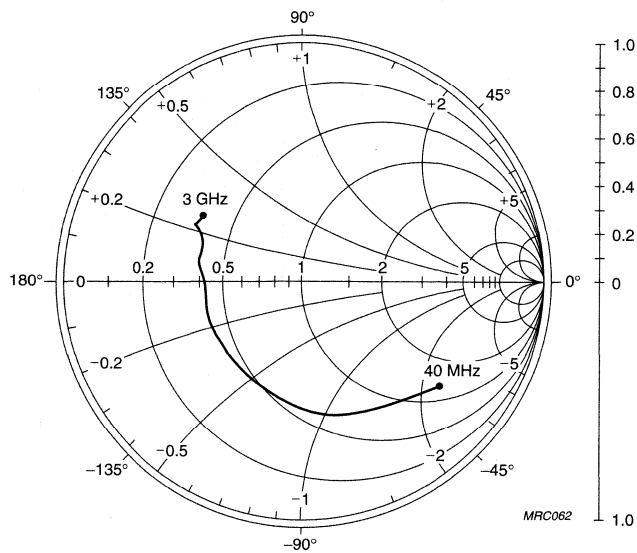


Fig.13 Noise circle.

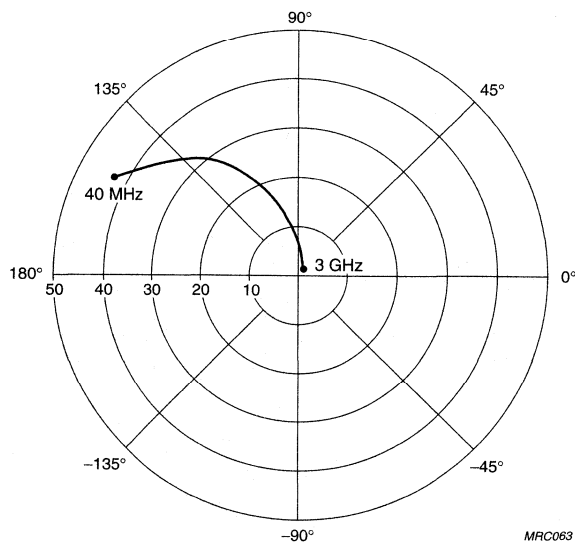
NPN 9 GHz wideband transistor

BFS540



$I_C = 40 \text{ mA}$; $V_{CE} = 8 \text{ V}$;
 $Z_0 = 50 \Omega$.

Fig.14 Common emitter input reflection coefficient (S_{11}).

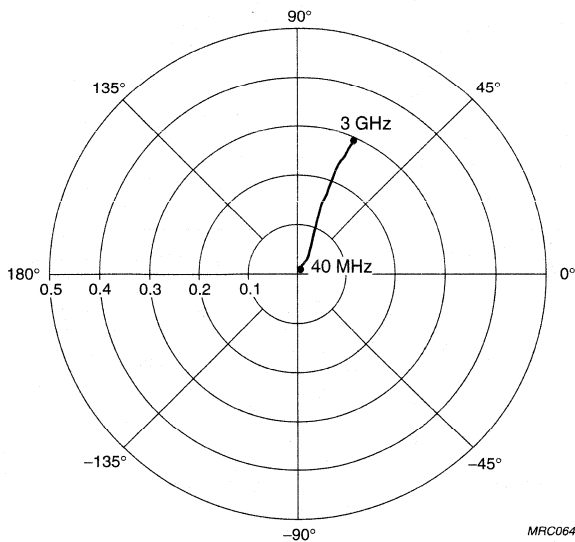


$I_C = 40 \text{ mA}$; $V_{CE} = 8 \text{ V}$.

Fig.15 Common emitter forward transmission coefficient (S_{21}).

NPN 9 GHz wideband transistor

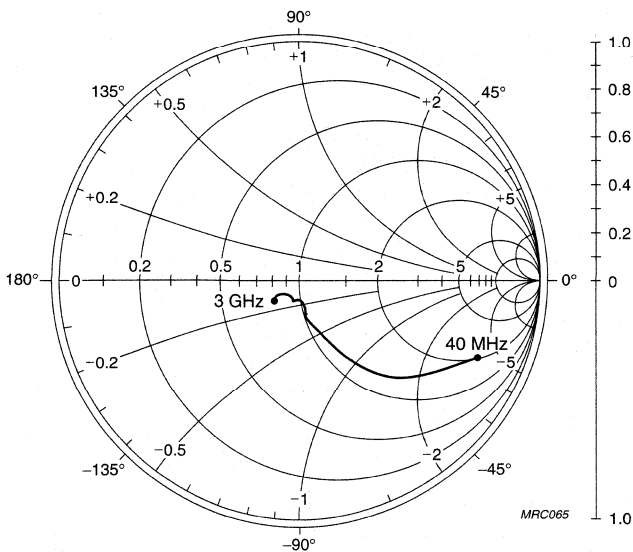
BFS540



MRC064

$I_C = 40 \text{ mA}; V_{CE} = 8 \text{ V}.$

Fig.16 Common emitter reverse transmission coefficient (S_{12}).



MRC065

$I_C = 40 \text{ mA}; V_{CE} = 8 \text{ V};$
 $Z_0 = 50 \Omega.$

Fig.17 Common emitter output reflection coefficient (S_{22}).

NPN 2 GHz wideband transistor

BFT25

DESCRIPTION

NPN transistor in a plastic SOT23 envelope.

It is primarily intended for use in RF low power amplifiers, such as in pocket phones, paging systems, etc. The transistor features low current consumption (100 μ A to 1 mA); due to its high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: V1p | |
| 1 | base |
| 2 | emitter |
| 3 | collector |

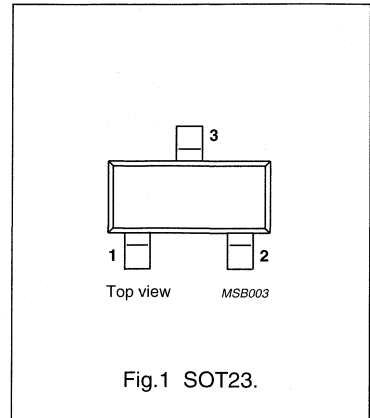


Fig.1 SOT23.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|
| V_{CB0} | collector-base voltage | open emitter | – | 8 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 5 | V |
| I_C | DC collector current | | – | 6.5 | mA |
| P_{tot} | total power dissipation | up to $T_s = 167\text{ }^\circ\text{C}$; note 1 | – | 30 | mW |
| f_T | transition frequency | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 2.3 | – | GHz |
| C_{re} | feedback capacitance | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 0.45 | pF |
| G_{UM} | maximum unilateral power gain | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 18 | – | dB |
| F | noise figure | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 3.8 | – | dB |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|--|------|------|------------------|
| V_{CB0} | collector-base voltage | open emitter | – | 8 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 5 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I_C | DC collector current | | – | 6.5 | mA |
| I_{CM} | peak collector current | $f > 1\text{ MHz}$ | – | 10 | mA |
| P_{tot} | total power dissipation | up to $T_s = 167\text{ }^\circ\text{C}$; note 1 | – | 30 | mW |
| T_{stg} | storage temperature | | –65 | 150 | $^\circ\text{C}$ |
| T_j | junction temperature | | – | 175 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 2 GHz wideband transistor

BFT25

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|--|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 167^\circ\text{C}$; note 1 | 260 K/W |

Note

- T_s = is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

$T_j = 25^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = 5\text{ V}$ | – | – | 50 | nA |
| h_{FE} | DC current gain | $I_C = 10\ \mu\text{A}$; $V_{CE} = 1\text{ V}$ | 20 | 30 | – | |
| | | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$ | 20 | 40 | – | |
| f_T | transition frequency | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 500\text{ MHz}$ | 1.2 | 2.3 | – | GHz |
| C_c | collector capacitance | $I_E = I_B = 0$; $V_{CB} = 0.5\text{ V}$; $f = 1\text{ MHz}$ | – | – | 0.6 | pF |
| C_e | emitter capacitance | $I_C = I_C = 0$; $V_{EB} = 0$; $f = 1\text{ MHz}$ | – | – | 0.5 | pF |
| C_{re} | feedback capacitance | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 1\text{ MHz}$; $T_{amb} = 25^\circ\text{C}$ | – | – | 0.45 | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25^\circ\text{C}$ | – | 18 | – | dB |
| | | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 800\text{ MHz}$; $T_{amb} = 25^\circ\text{C}$ | – | 12 | – | dB |
| F | noise figure | $I_C = 0.1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25^\circ\text{C}$ | – | 5.5 | – | dB |
| | | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25^\circ\text{C}$ | – | 3.8 | – | dB |

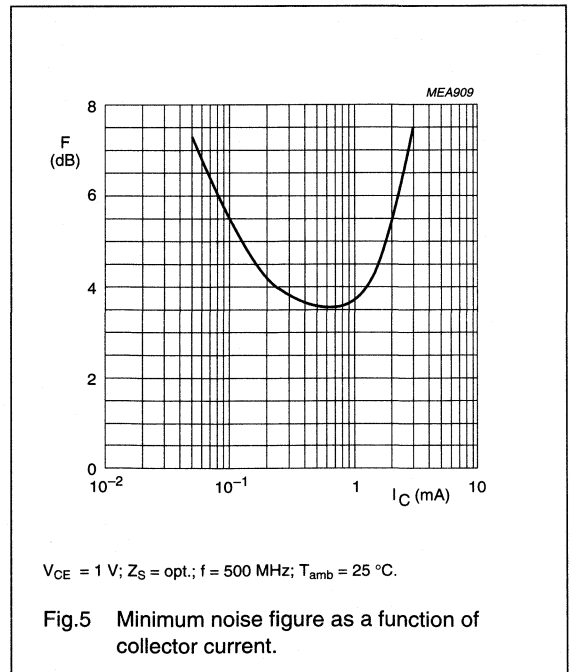
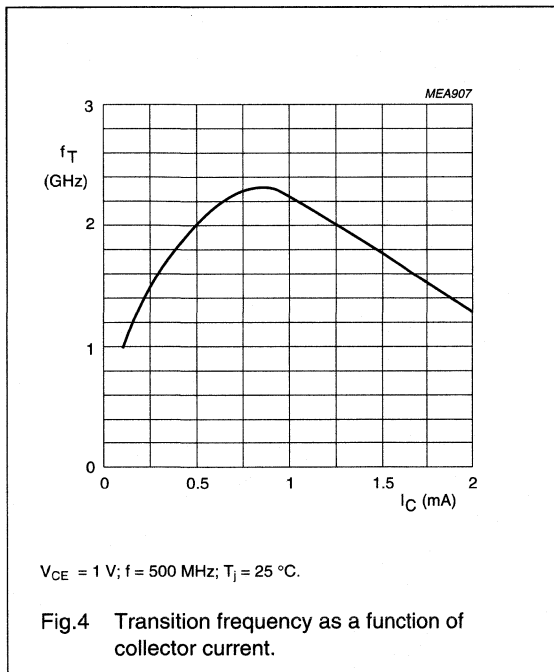
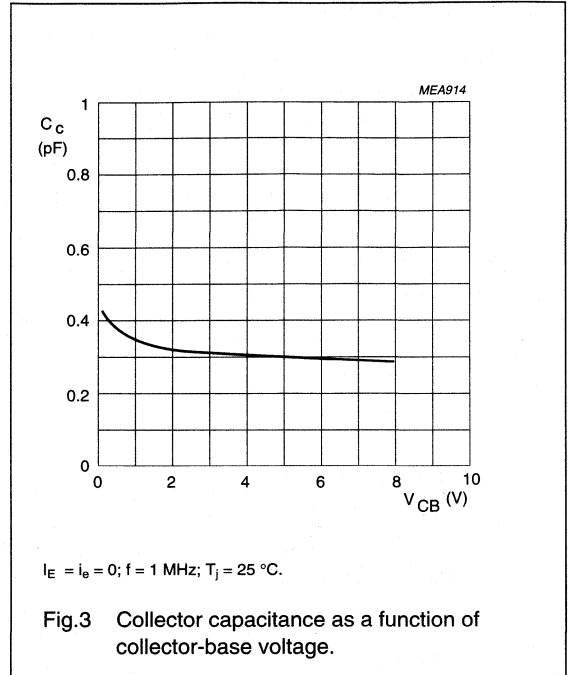
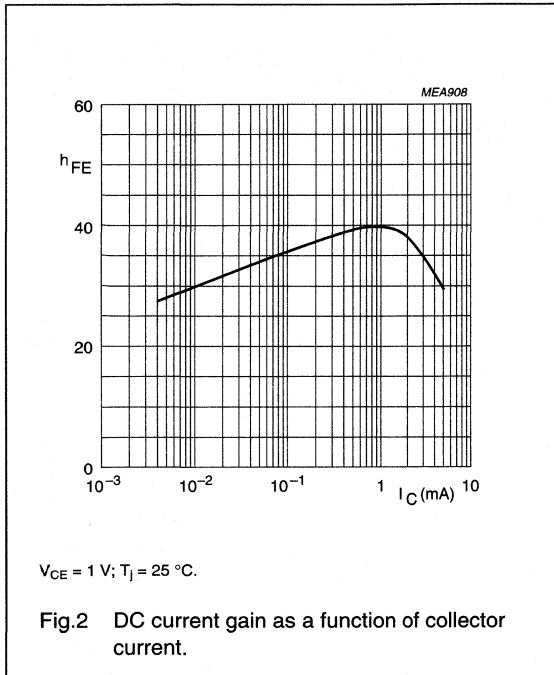
Note

- G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{dB.}$$

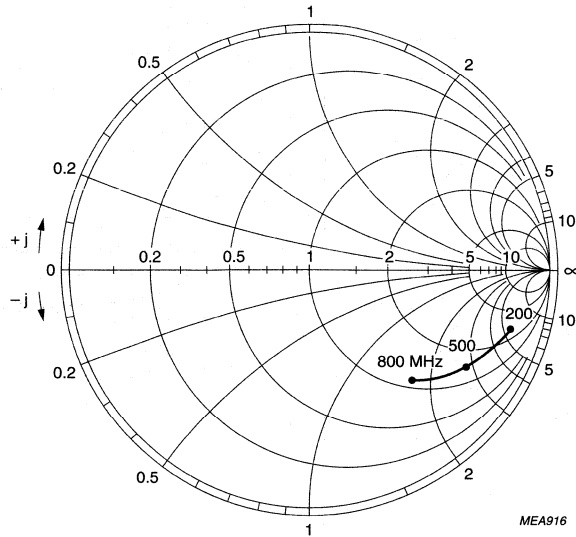
NPN 2 GHz wideband transistor

BFT25



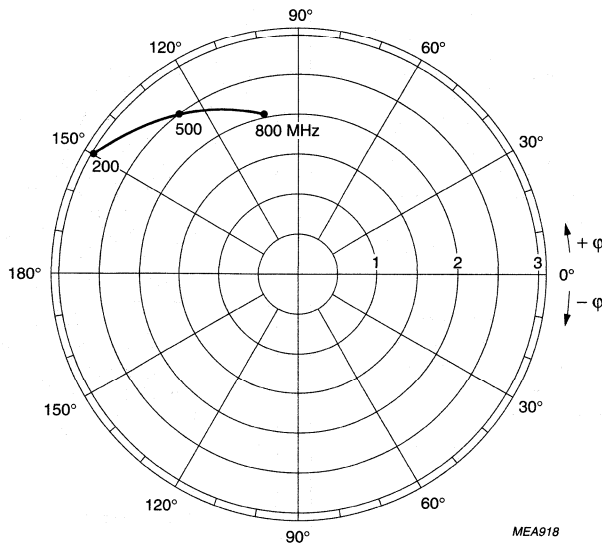
NPN 2 GHz wideband transistor

BFT25



$I_C = 1 \text{ mA}$; $V_{CE} = 1 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.
 $Z_o = 50 \text{ } \Omega$.

Fig.6 Common emitter input reflection coefficient (S_{11}).

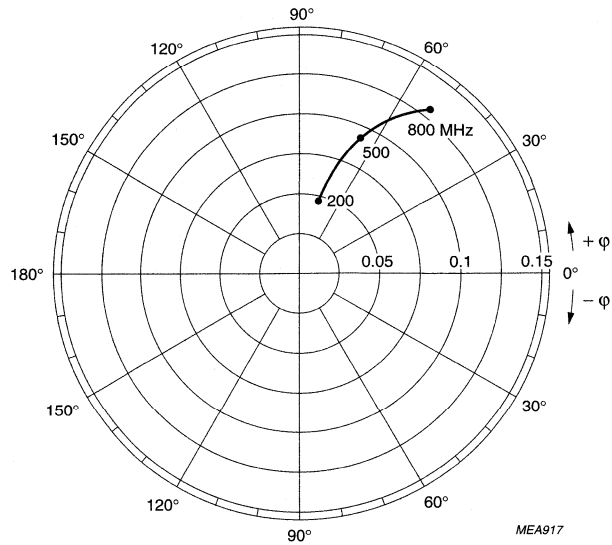


$I_C = 1 \text{ mA}$; $V_{CE} = 1 \text{ V}$; $T_{amb} = 25 \text{ }^\circ\text{C}$.

Fig.7 Common emitter forward transmission coefficient (S_{21}).

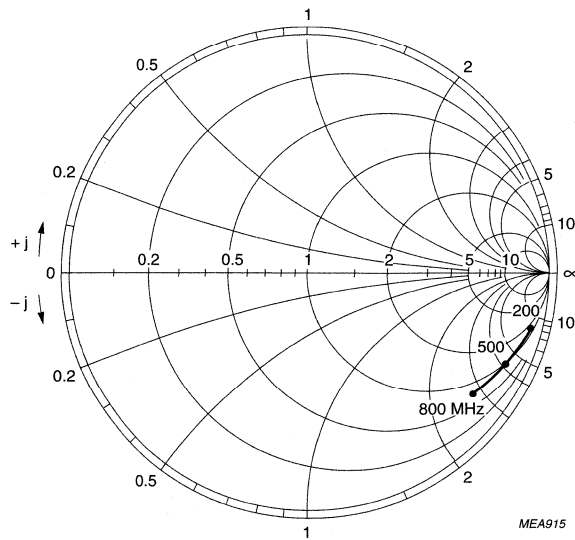
NPN 2 GHz wideband transistor

BFT25



$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}.$

Fig.8 Common emitter reverse transmission coefficient (S_{12}).



$I_C = 1 \text{ mA}; V_{CE} = 1 \text{ V}; T_{amb} = 25 \text{ }^\circ\text{C}.$
 $Z_o = 50 \text{ } \Omega.$

Fig.9 Common emitter output reflection coefficient (S_{22}).

NPN 5 GHz wideband transistor

BFT25A

FEATURES

- Low current consumption (100 μ A – 1 mA)
- Low noise figure
- Gold metallization ensures excellent reliability.

DESCRIPTION

The BFT25A is a silicon npn transistor, primarily intended for use in RF low power amplifiers, such as pocket telephones and paging systems with signal frequencies up to 2 GHz.

The transistor is encapsulated in a 3-pin plastic SOT23 envelope.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: V10 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |

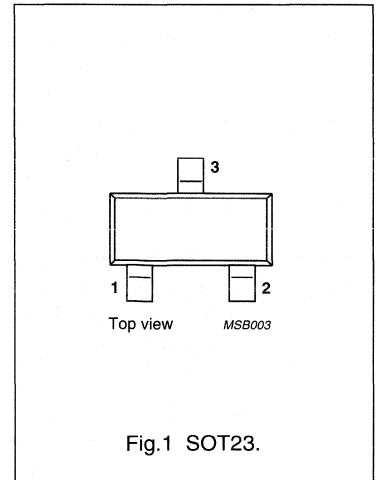


Fig.1 SOT23.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | 8 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | 5 | V |
| I_C | DC collector current | | – | – | 6.5 | mA |
| P_{tot} | total power dissipation | up to $T_s = 165\text{ }^\circ\text{C}$; note 1 | – | – | 32 | mW |
| h_{FE} | DC current gain | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$ | 50 | 80 | 200 | |
| f_T | transition frequency | $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 500\text{ MHz}$ | 3.5 | 5 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 15 | – | dB |
| F | noise figure | $\Gamma = \Gamma_{opt}$; $I_C = 0.5\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 1.8 | – | dB |
| | | $\Gamma = \Gamma_{opt}$; $I_C = 1\text{ mA}$; $V_{CE} = 1\text{ V}$; $T_{amb} = 25\text{ }^\circ\text{C}$; $f = 1\text{ GHz}$ | – | 2 | – | dB |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 5 GHz wideband transistor

BFT25A

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------------|---------------------------|--|------|------|------|
| V _{CBO} | collector-base voltage | open emitter | – | 8 | V |
| V _{CEO} | collector-emitter voltage | open base | – | 5 | V |
| V _{EBO} | emitter-base voltage | open collector | – | 2 | V |
| I _C | DC collector current | | – | 6.5 | mA |
| P _{tot} | total power dissipation | up to T _s = 165 °C; note 1 | – | 32 | mW |
| T _{stg} | storage temperature | | –65 | 150 | °C |
| T _j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------------|---|--------------------|
| R _{th j-s} | from junction to soldering point (note 1) | 260 K/W |

Note

1. T_s is the temperature at the soldering point of the collector tab.

CHARACTERISTICS

T_j = 25 °C unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|------------------|--|---|------|------|------|------|
| I _{CBO} | collector cut-off current | I _E = 0; V _{CB} = 5 V | – | – | 50 | nA |
| h _{FE} | DC current gain | I _C = 0.5 mA; V _{CE} = 1 V | 50 | 80 | 200 | |
| f _T | transition frequency | I _C = 1 mA; V _{CE} = 1 V; T _{amb} = 25 °C; f = 500 MHz | 3.5 | 5 | – | GHz |
| C _{re} | feedback capacitance | I _C = I _c = 0; V _{CB} = 1 V; f = 1 MHz | – | 0.3 | 0.45 | pF |
| G _{UM} | maximum unilateral power gain (note 1) | I _C = 0.5 mA; V _{CE} = 1 V; T _{amb} = 25 °C; f = 1 GHz | – | 15 | – | dB |
| F | noise figure | Γ = Γ _{opt} ; I _C = 0.5 mA; V _{CE} = 1 V; T _{amb} = 25 °C; f = 1 GHz | – | 1.8 | – | dB |
| | | Γ = Γ _{opt} ; I _C = 1 mA; V _{CE} = 1 V; T _{amb} = 25 °C; f = 1 GHz | – | 2 | – | dB |

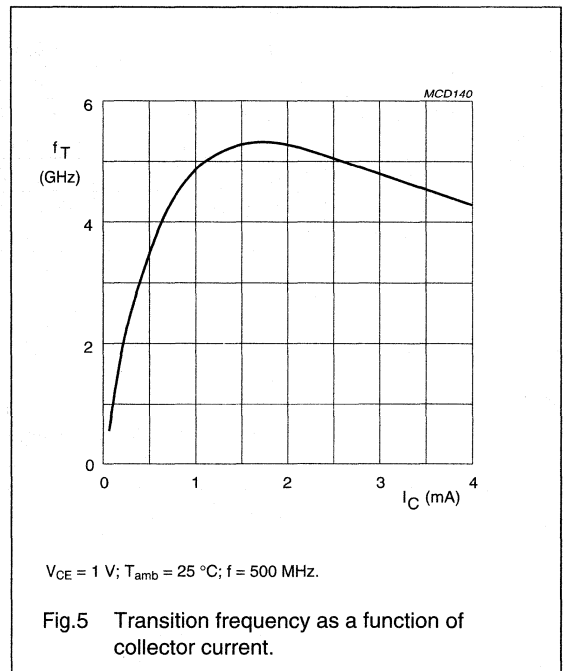
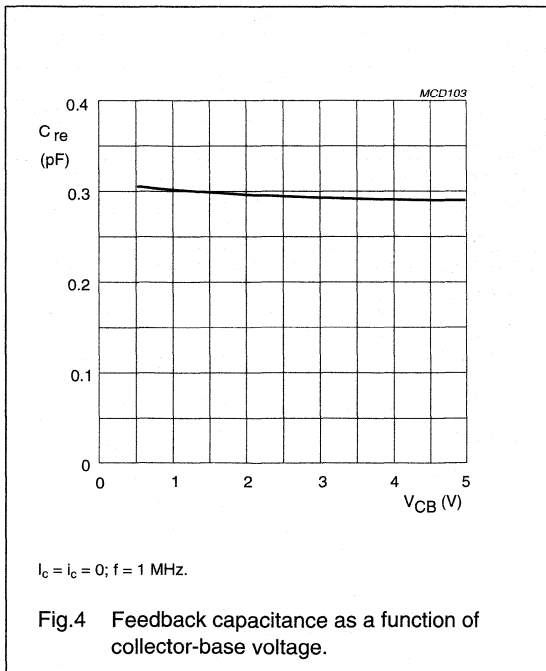
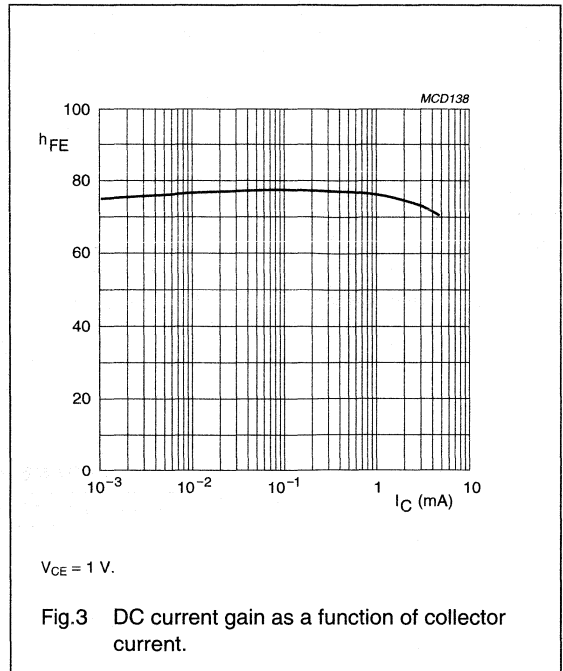
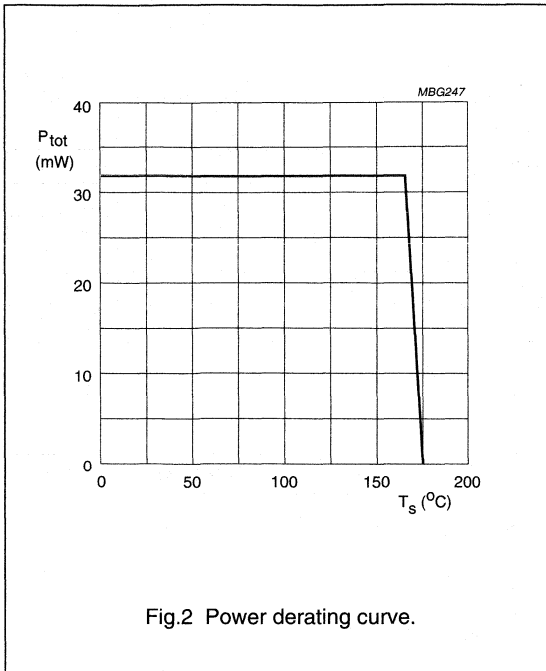
Note

1. G_{UM} is the maximum unilateral power gain, assuming S₁₂ is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{dB.}$$

NPN 5 GHz wideband transistor

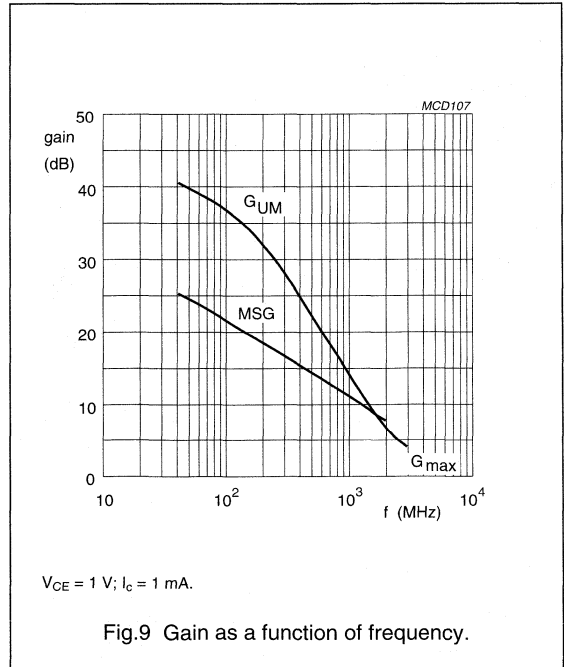
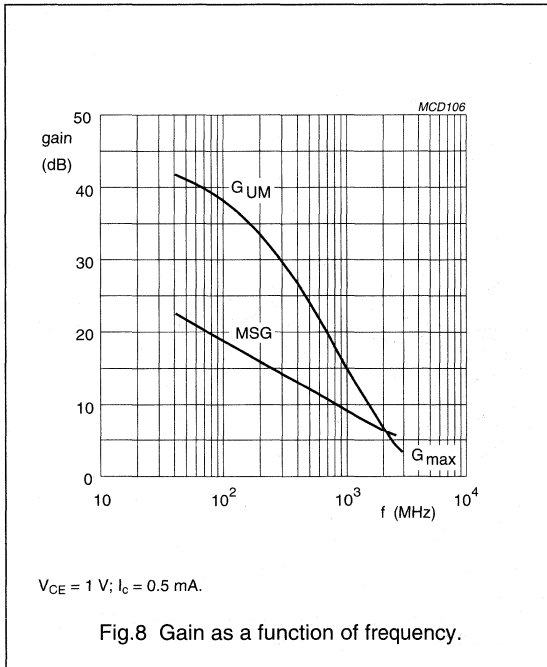
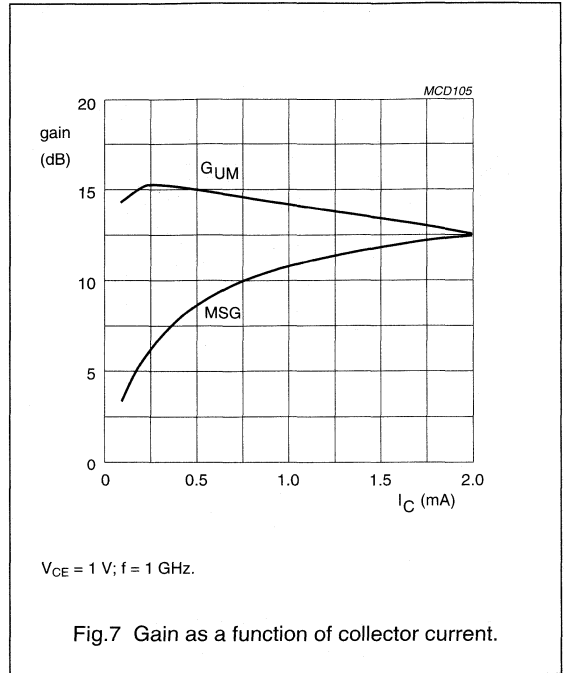
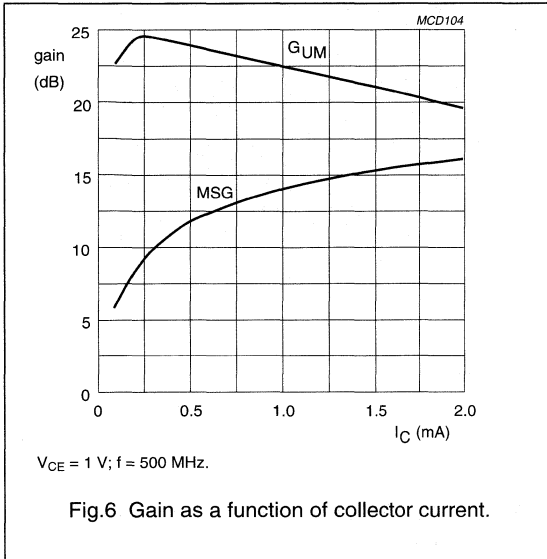
BFT25A



NPN 5 GHz wideband transistor

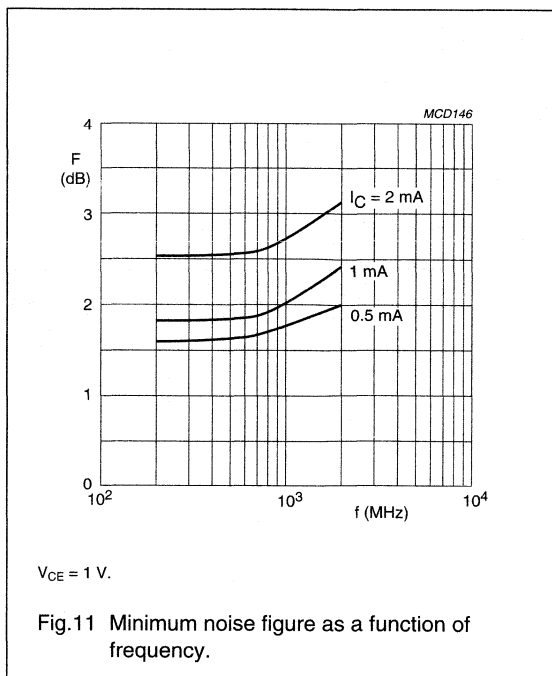
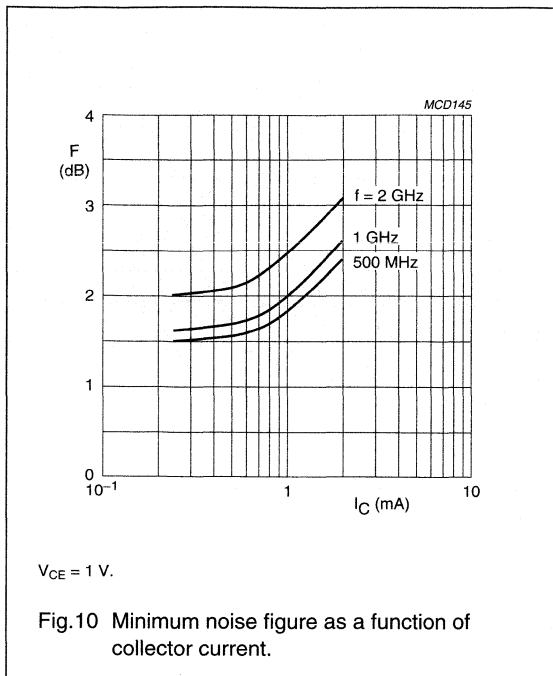
BFT25A

In Figs 6 to 9, G_{UM} = maximum unilateral power gain; MSG = maximum stable gain; G_{max} = maximum available gain.



NPN 5 GHz wideband transistor

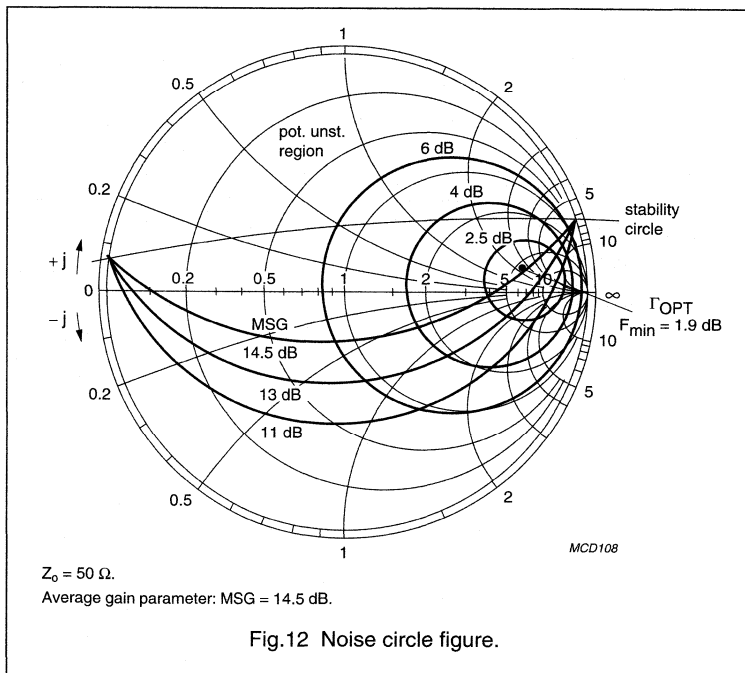
BFT25A



| f (MHz) | V_{CE} (V) | I_C (mA) |
|---------|--------------|------------|
| 500 | 1 | 1 |

Noise Parameters

| F_{min} (dB) | Gamma (opt) | | $R_n/50$ |
|----------------|-------------|-------|----------|
| | (mag) | (ang) | |
| 1.9 | 0.79 | 4 | 2.5 |



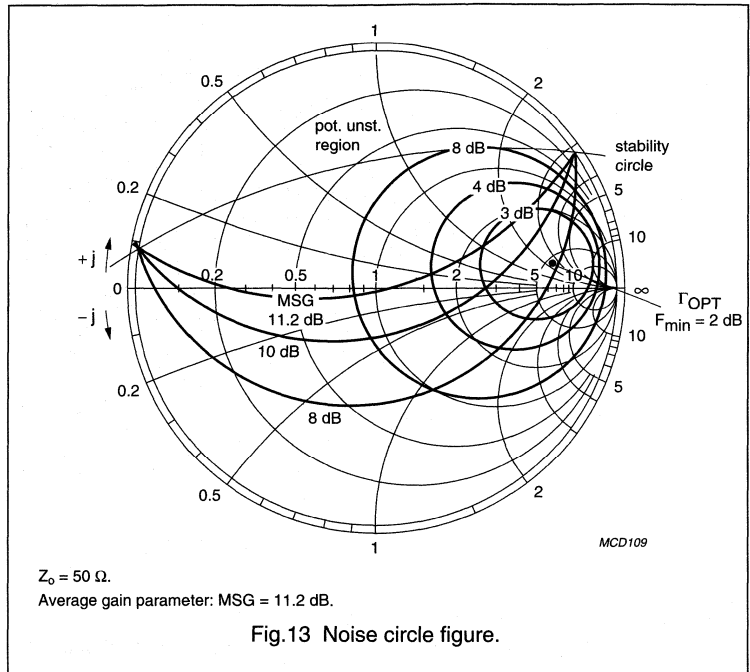
NPN 5 GHz wideband transistor

BFT25A

| f (MHz) | V _{CE} (V) | I _C (mA) |
|---------|---------------------|---------------------|
| 1000 | 1 | 1 |

Noise Parameters

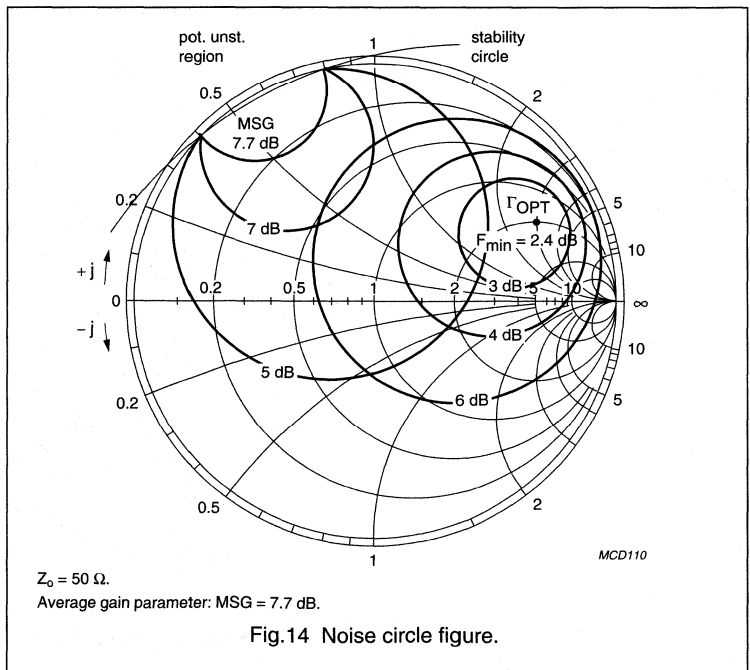
| F _{min} (dB) | Gamma (opt) | | R _n /50 |
|-----------------------|-------------|-------|--------------------|
| | (mag) | (ang) | |
| 2 | 0.74 | 8 | 2.6 |



| f (MHz) | V _{CE} (V) | I _C (mA) |
|---------|---------------------|---------------------|
| 2000 | 1 | 1 |

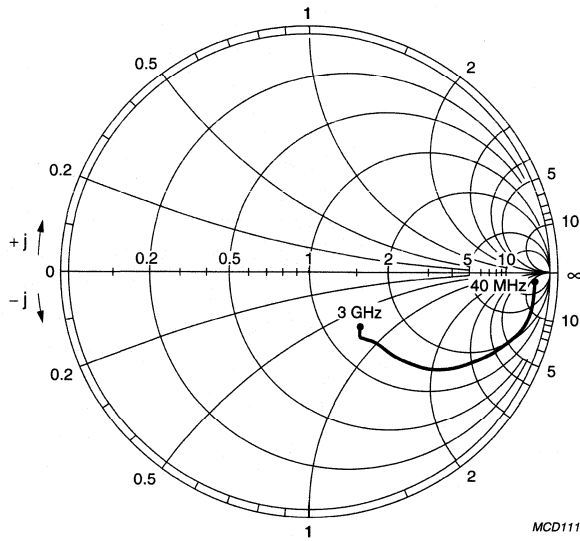
Noise Parameters

| F _{min} (dB) | Gamma (opt) | | R _n /50 |
|-----------------------|-------------|-------|--------------------|
| | (mag) | (ang) | |
| 2.4 | 0.72 | 26 | 1.7 |



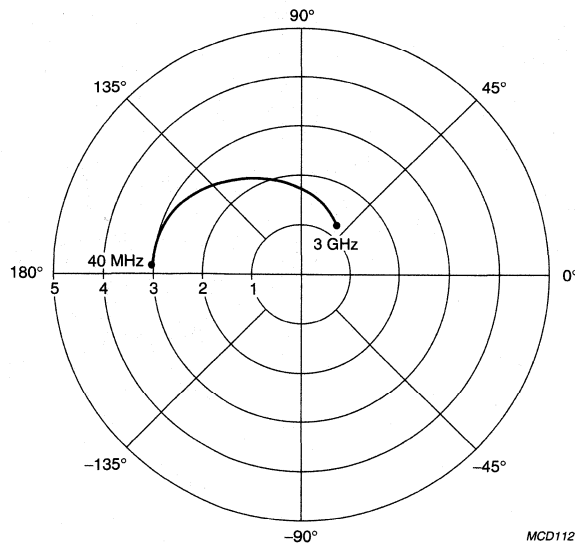
NPN 5 GHz wideband transistor

BFT25A



$V_{CE} = 1 \text{ V}; I_C = 1 \text{ mA}.$
 $Z_0 = 50 \Omega.$

Fig.15 Common emitter input reflection coefficient (S_{11}).

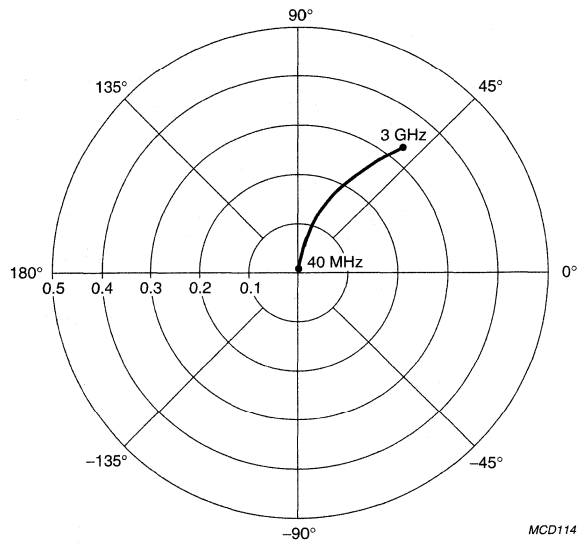


$V_{CE} = 1 \text{ V}; I_C = 1 \text{ mA}.$

Fig.16 Common emitter forward transmission coefficient (S_{21}).

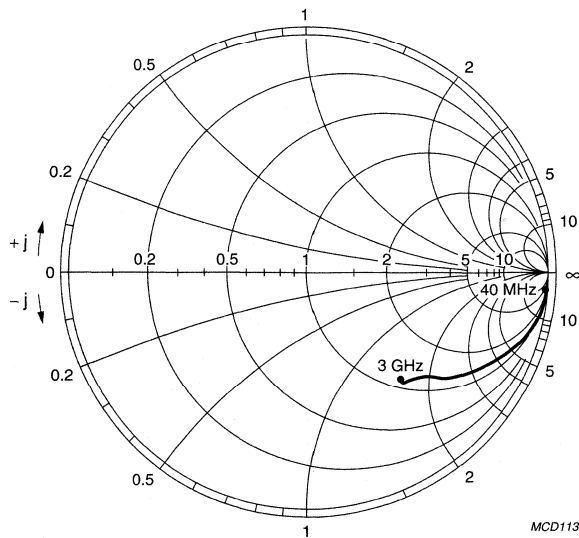
NPN 5 GHz wideband transistor

BFT25A



$V_{CE} = 1\text{ V}; I_C = 1\text{ mA}$.

Fig.17 Common emitter reverse transmission coefficient (S_{12}).



$V_{CE} = 1\text{ V}; I_C = 1\text{ mA}$.
 $Z_0 = 50\ \Omega$.

Fig.18 Common emitter output reflection coefficient (S_{22}).

PNP 5 GHz wideband transistor

BFT92

DESCRIPTION

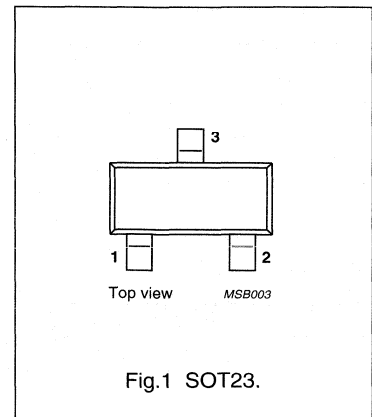
PNP transistor in a plastic SOT23 envelope.

It is primarily intended for use in RF wideband amplifiers, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analyzers, etc. The transistor features low intermodulation distortion and high power gain; due to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

NPN complements are BFR92 and BFR92A.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: W1p | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | –20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | –15 | V |
| I_C | DC collector current | | – | –25 | mA |
| P_{tot} | total power dissipation | up to $T_s = 95\text{ °C}$; note 1 | – | 300 | mW |
| f_T | transition frequency | $I_C = -14\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$ | 5 | – | GHz |
| C_{re} | feedback capacitance | $I_C = -2\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 1\text{ MHz}$ | 0.7 | – | pF |
| G_{UM} | maximum unilateral power gain | $I_C = -14\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 18 | – | dB |
| F | noise figure | $I_C = -5\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 2.5 | – | dB |
| d_{im} | intermodulation distortion | $I_C = -14\text{ mA}$; $V_{CE} = -10\text{ V}$; $R_L = 75\text{ }\Omega$; $V_o = 150\text{ mV}$; $T_{amb} = 25\text{ °C}$; $f_{(p+q-r)} = 493.25\text{ MHz}$ | –60 | – | dB |

Note

- T_s is the temperature at the soldering point of the collector tab.

PNP 5 GHz wideband transistor

BFT92

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-----------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | –20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | –15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | –2 | V |
| I_C | DC collector current | | – | –25 | mA |
| I_{CM} | peak collector current | $f > 1$ MHz | – | –35 | mA |
| P_{tot} | total power dissipation | up to $T_s = 95$ °C; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|-----------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 95$ °C; note 1 | 260 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

PNP 5 GHz wideband transistor

BFT92

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|---|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = -10\text{ V};$ | – | – | –50 | nA |
| h_{FE} | DC current gain | $I_C = -14\text{ mA}; V_{CE} = -10\text{ V}$ | 20 | 50 | – | |
| f_T | transition frequency | $I_C = -14\text{ mA}; V_{CE} = -10\text{ V};$ $f = 500\text{ MHz}$ | – | 5 | – | GHz |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = -10\text{ V}; f = 1\text{ MHz}$ | – | 0.75 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0; V_{EB} = -0.5\text{ V}; f = 1\text{ MHz}$ | – | 0.8 | – | pF |
| C_{re} | feedback capacitance | $I_C = -2\text{ mA}; V_{CE} = -10\text{ V}; f = 1\text{ MHz}$ | – | 0.7 | – | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = -14\text{ mA}; V_{CE} = -10\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 18 | – | dB |
| F | noise figure | $I_C = -5\text{ mA}; V_{CE} = -10\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 2.5 | – | dB |
| V_o | output voltage | note 2 | – | 150 | – | mV |

Notes

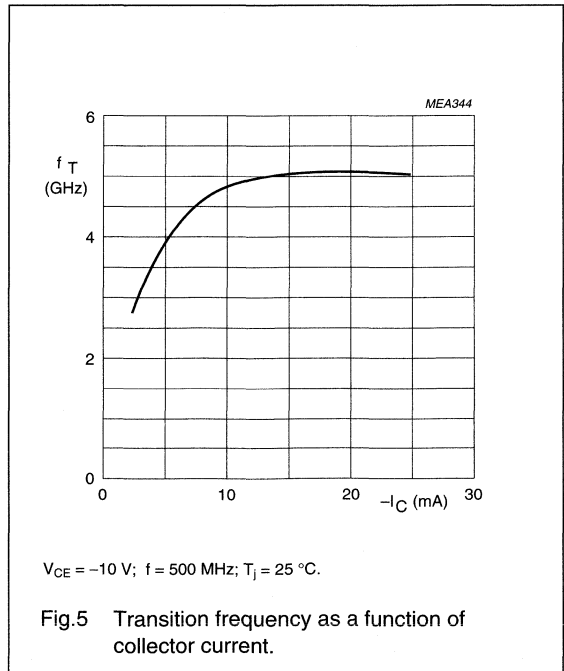
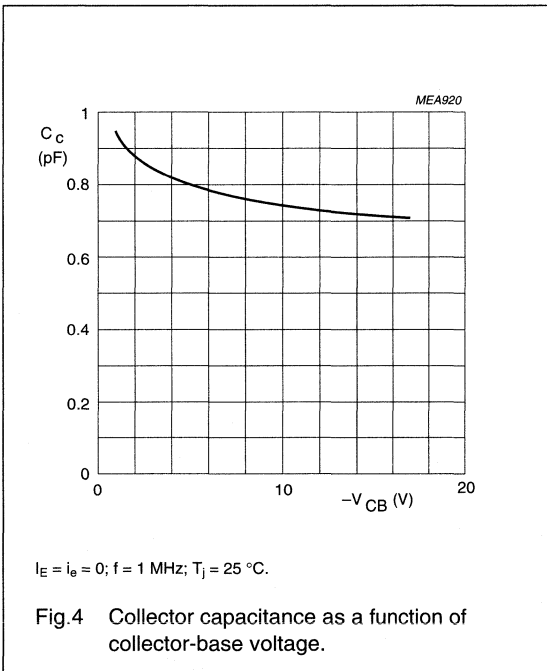
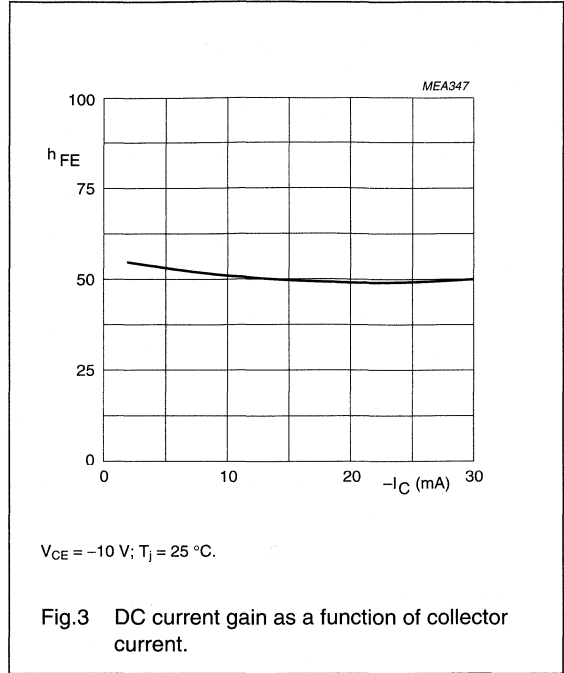
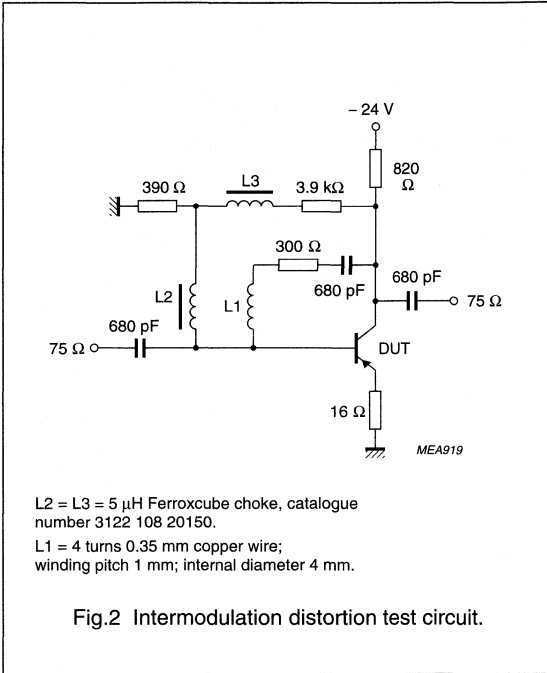
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{ dB.}$$

2. $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = -14\text{ mA}; V_{CE} = -10\text{ V}; R_L = 75\ \Omega;$
 $V_p = V_o$ at $d_{im} = -60\text{ dB}; f_p = 495.25\text{ MHz};$
 $V_q = V_o - 6\text{ dB}; f_q = 503.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_r = 505.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 493.25\text{ MHz}.$

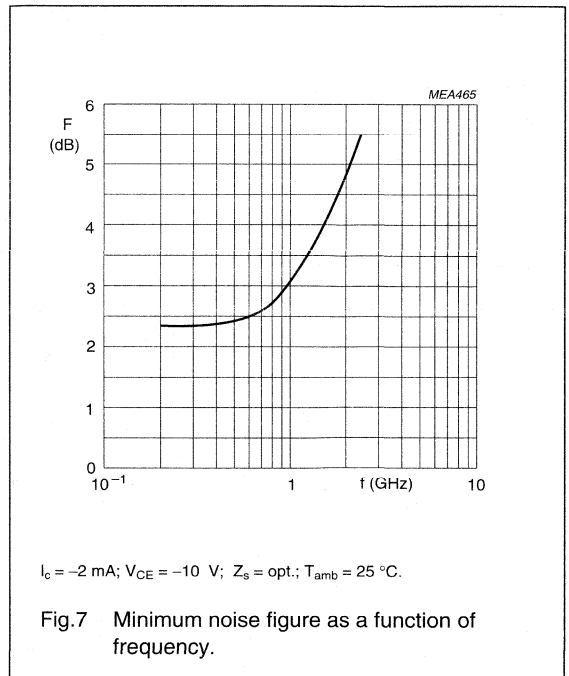
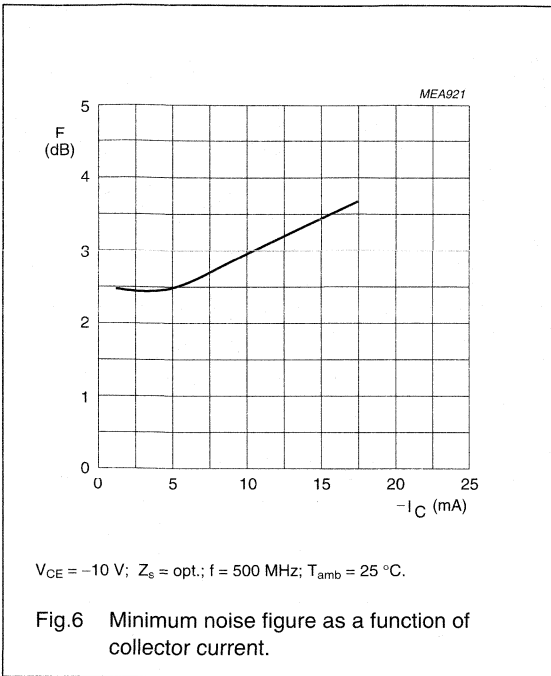
PNP 5 GHz wideband transistor

BFT92



PNP 5 GHz wideband transistor

BFT92



PNP 4 GHz wideband transistor

BFT92W

FEATURES

- High power gain
- Gold metallization ensures excellent reliability
- SOT323 (S-mini) package.

APPLICATION

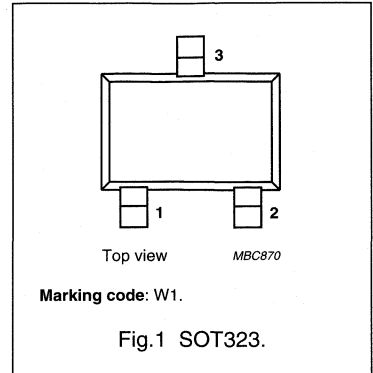
It is intended as a general purpose transistor for wideband applications up to 2 GHz.

DESCRIPTION

Silicon PNP transistor in a plastic, SOT323 (S-mini) package. The BFT92W uses the same crystal as the SOT23 version, BFT92.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | –20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | –15 | V |
| I_C | collector current (DC) | | – | – | –35 | mA |
| P_{tot} | total power dissipation | up to $T_s = 93\text{ °C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = -15\text{ mA}$; $V_{CE} = -10\text{ V}$ | 20 | 50 | – | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = -10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| f_T | transition frequency | $I_C = -15\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$ | – | 4 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = -15\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 17 | – | dB |
| F | noise figure | $I_C = -5\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$ | – | 2.5 | – | dB |
| T_j | junction temperature | | – | – | 150 | °C |

Note

1. T_s is the temperature at the soldering point of the collector pin.

PNP 4 GHz wideband transistor

BFT92W

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | –20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | –15 | V |
| V_{EBO} | emitter-base voltage | open collector | – | –2 | V |
| I_C | collector current (DC) | | – | –25 | mA |
| P_{tot} | total power dissipation | up to $T_s = 93\text{ °C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 150 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|-------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 93\text{ °C}$; note 1 | 190 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ °C}$ (unless otherwise specified).

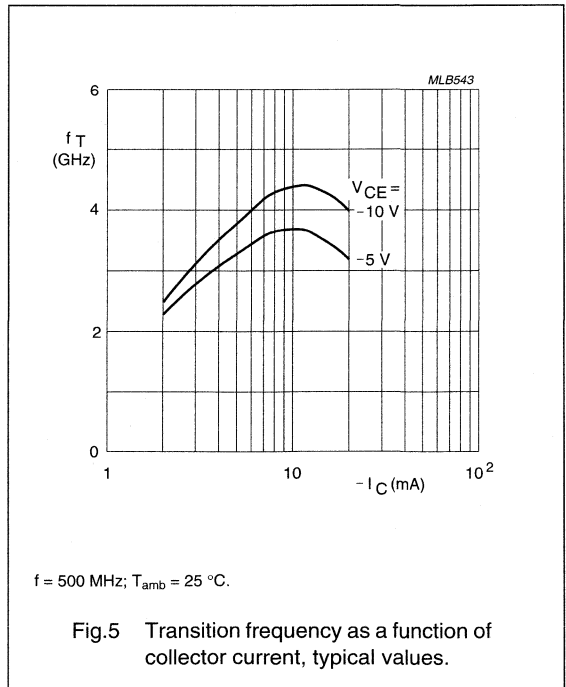
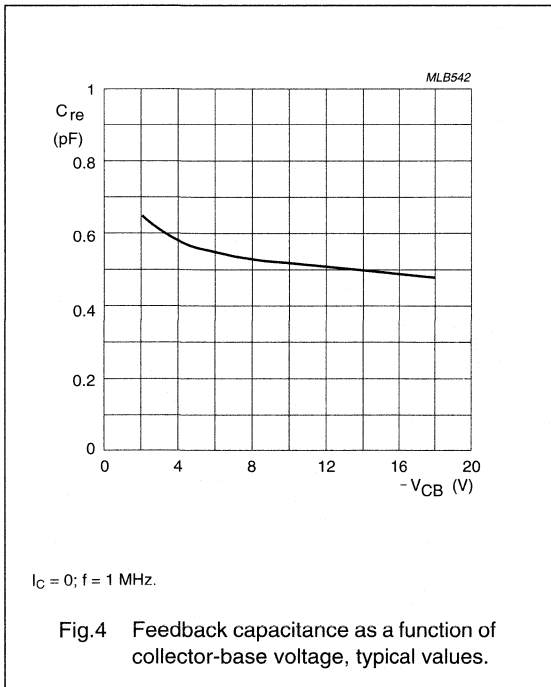
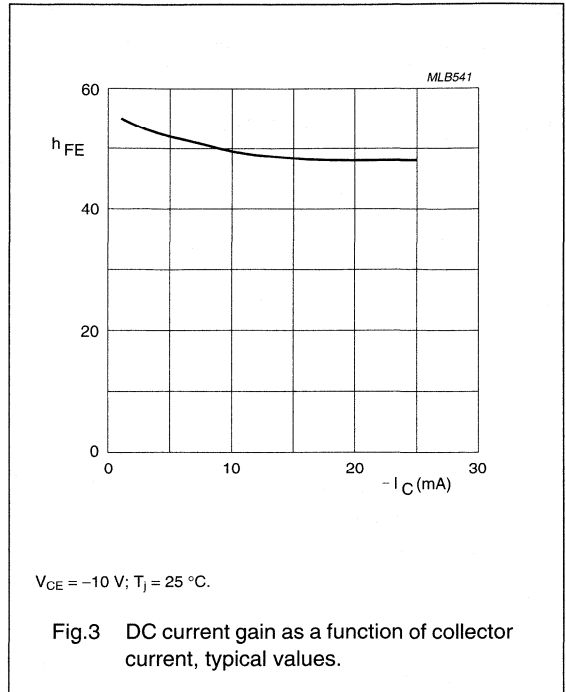
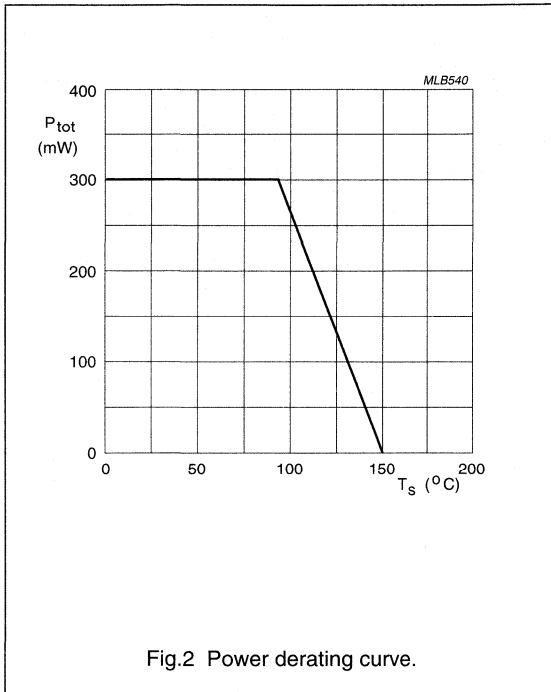
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|--|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = -10\text{ V}$ | – | – | –50 | nA |
| h_{FE} | DC current gain | $I_C = -15\text{ mA}$; $V_{CE} = -10\text{ V}$ | 20 | 50 | – | |
| f_T | transition frequency | $I_C = -15\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 4 | – | GHz |
| C_c | collector capacitance | $I_E = I_E = 0$; $V_{CB} = -10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.65 | – | pF |
| C_e | emitter capacitance | $I_C = I_C = 0$; $V_{EB} = -0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 0.75 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CB} = -10\text{ V}$; $f = 1\text{ MHz}$ | – | 0.5 | – | pF |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = -15\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 17 | – | dB |
| | | $I_C = -15\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 11 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = -5\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 500\text{ MHz}$ | – | 2.5 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = -5\text{ mA}$; $V_{CE} = -10\text{ V}$; $f = 1\text{ GHz}$ | – | 3 | – | dB |

Note

- G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

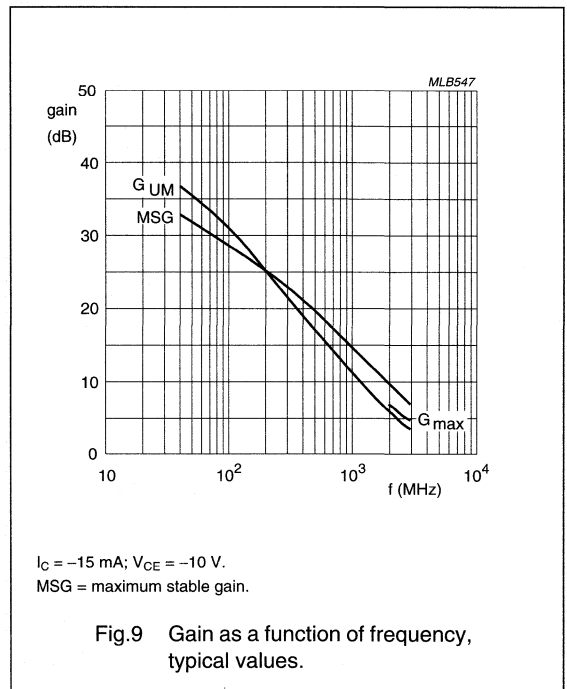
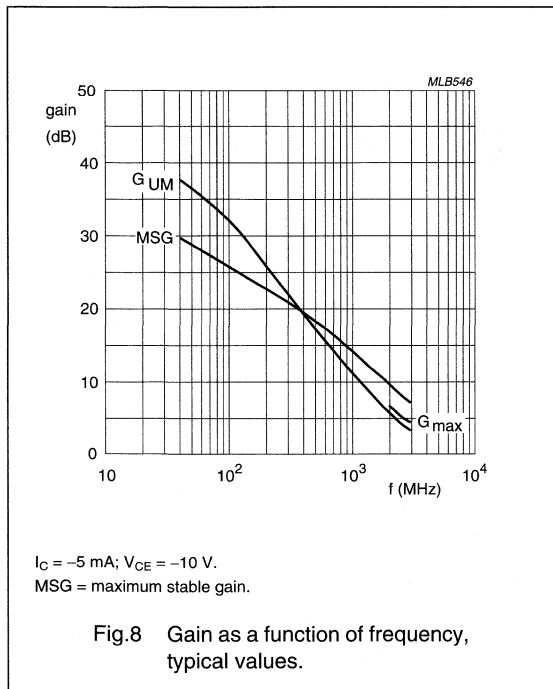
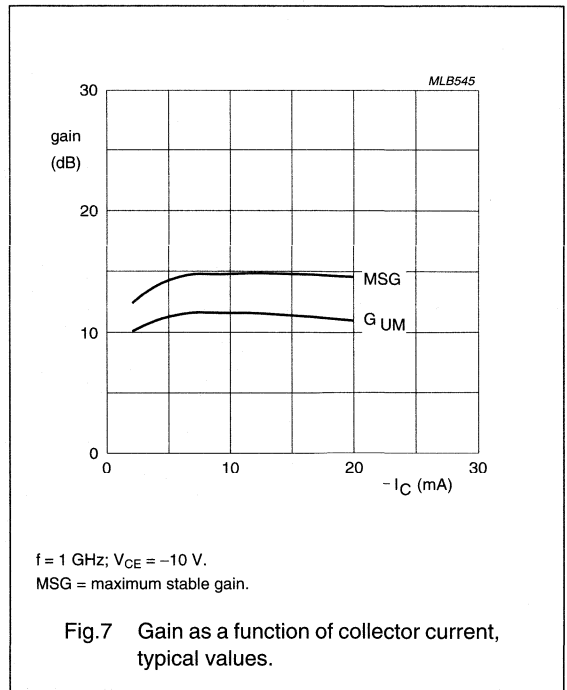
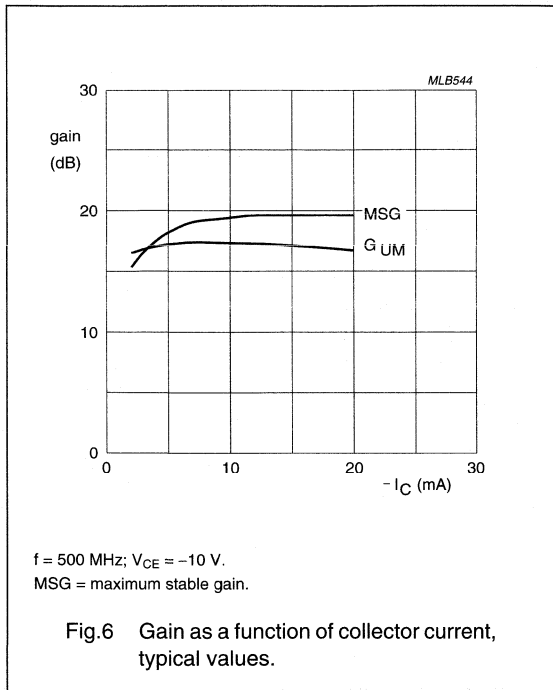
PNP 4 GHz wideband transistor

BFT92W



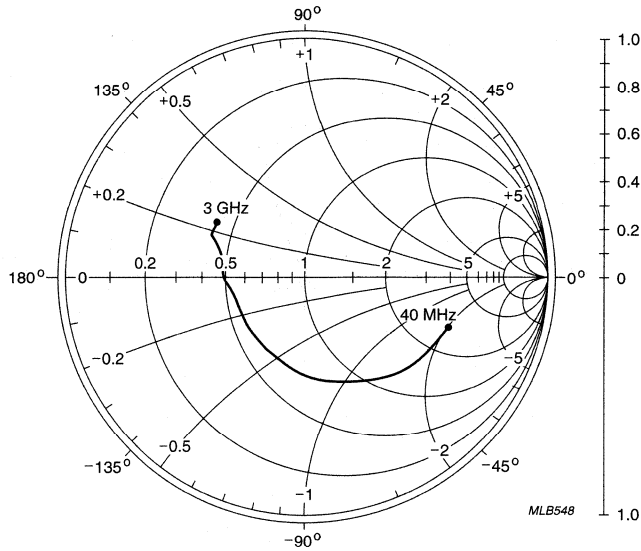
PNP 4 GHz wideband transistor

BFT92W



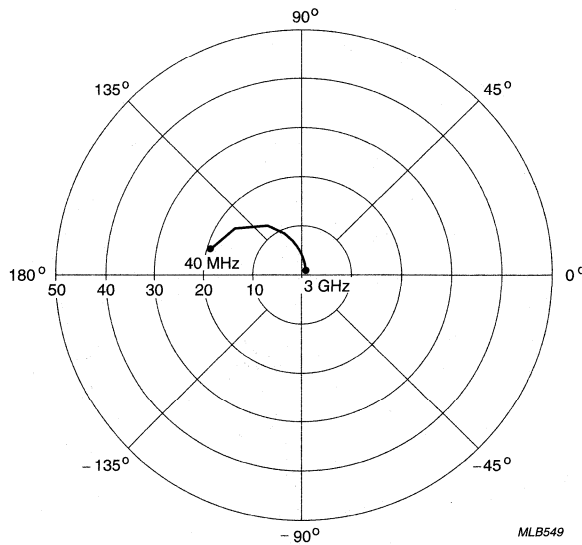
PNP 4 GHz wideband transistor

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$V_{CE} = -10\text{ V}; I_C = -15\text{ mA}$.

Fig.10 Common emitter input reflection coefficient (s_{11}), typical values.

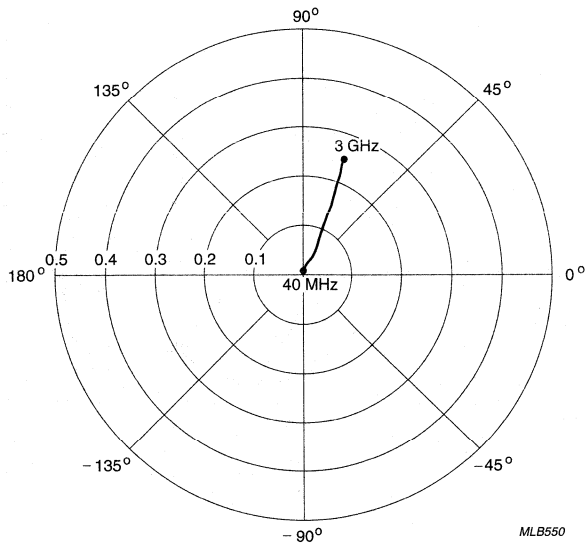


$V_{CE} = -10\text{ V}; I_C = -15\text{ mA}$.

Fig.11 Common emitter forward transmission coefficient (s_{21}), typical values.

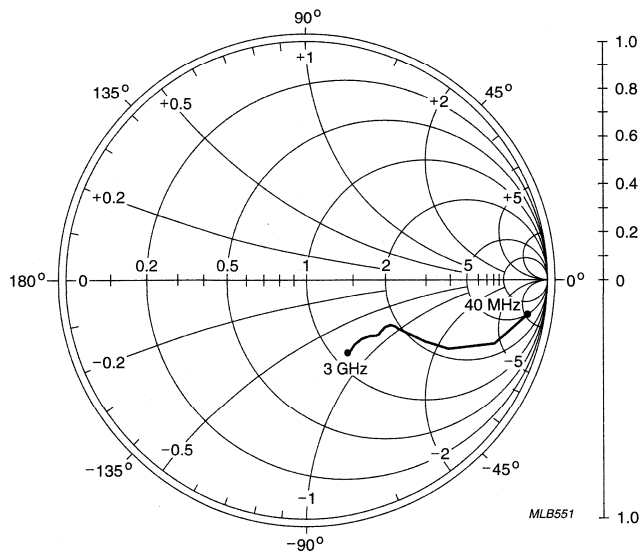
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$V_{CE} = -10\text{ V}; I_C = -15\text{ mA}$.

Fig.12 Common emitter reverse transmission coefficient (s_{12}), typical values.

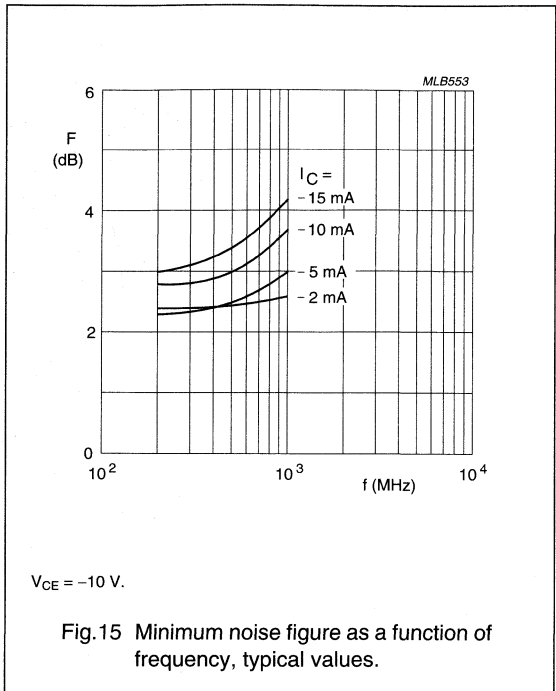
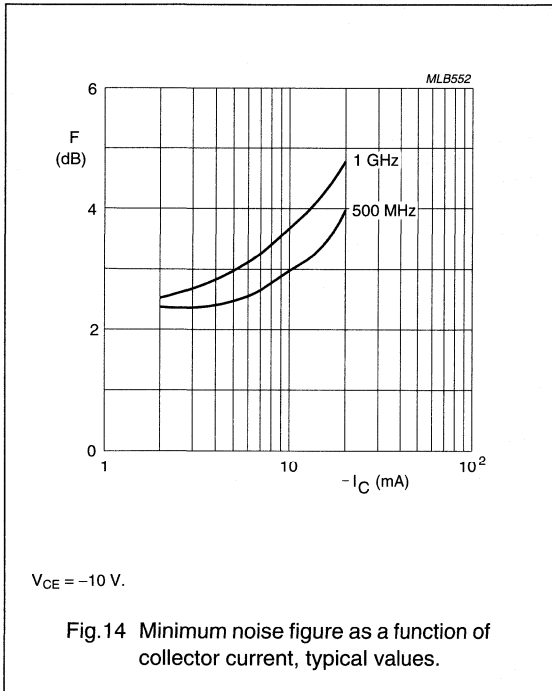


$V_{CE} = -10\text{ V}; I_C = -15\text{ mA}$.

Fig.13 Common emitter output reflection coefficient (s_{22}), typical values.

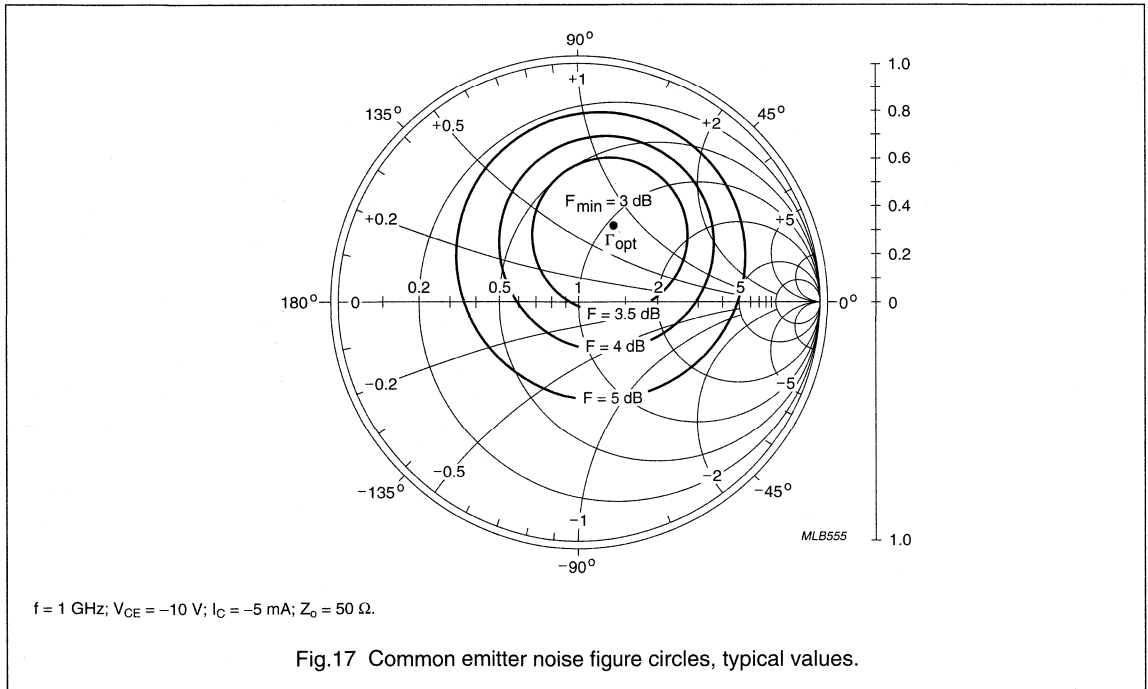
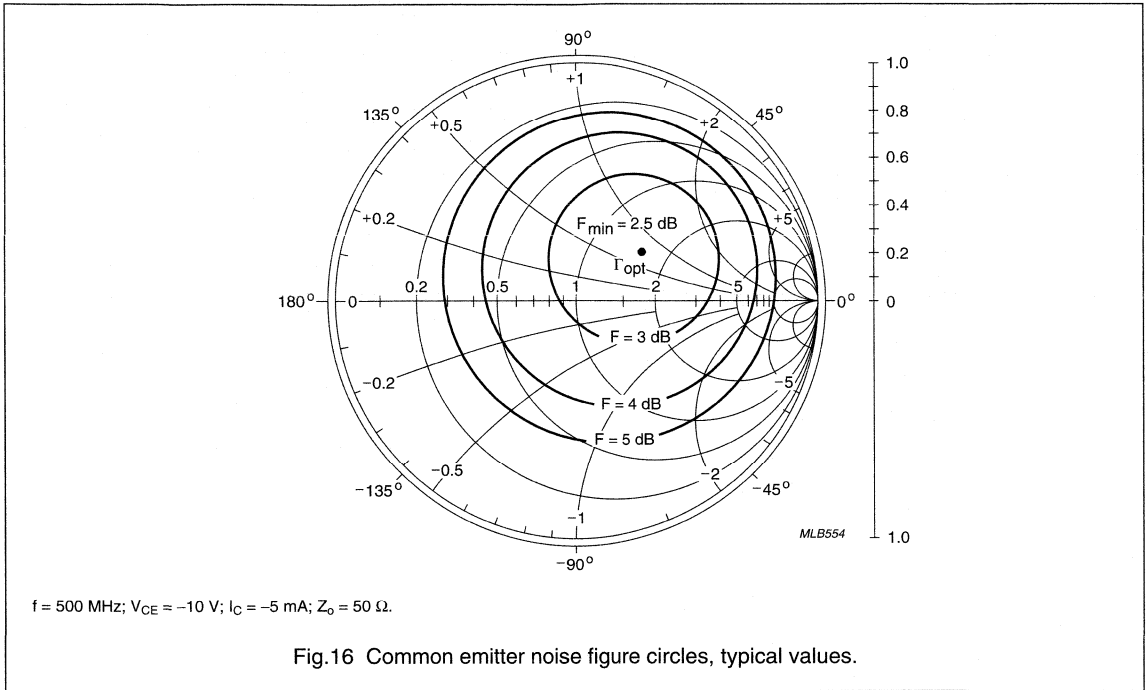
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PNP 4 GHz wideband transistor

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PNP 4 GHz wideband transistor

BFT92W

SPICE parameters for the BFT92W crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 1 | IS | 437.5 | aA |
| 2 | BF | 33.58 | – |
| 3 | NF | 1.009 | – |
| 4 | VAF | 23.39 | V |
| 5 | IKF | 99.53 | mA |
| 6 | ISE | 87.05 | fA |
| 7 | NE | 1.943 | – |
| 8 | BR | 4.947 | – |
| 9 | NR | 1.002 | – |
| 10 | VAR | 3.903 | V |
| 11 | IKR | 5.281 | mA |
| 12 | ISC | 35.88 | fA |
| 13 | NC | 1.393 | – |
| 14 | RB | 5.000 | Ω |
| 15 | IRB | 1.000 | μA |
| 16 | RBM | 5.000 | Ω |
| 17 | RE | 1.000 | Ω |
| 18 | RC | 10.00 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 746.6 | fF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 0.357 | – |
| 25 | TF | 17.49 | ps |
| 26 | XTF | 1.354 | – |
| 27 | VTF | 155.6 | mV |
| 28 | ITF | 1.000 | mA |
| 29 | PTF | 45.00 | deg |
| 30 | CJC | 937.1 | fF |
| 31 | VJC | 396.4 | mV |
| 32 | MJC | 0.200 | – |
| 33 | XCJC | 0.106 | – |
| 34 | TR | 8.422 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 0.768 | – |

Note

1. These parameters have not been extracted, the default values are shown.

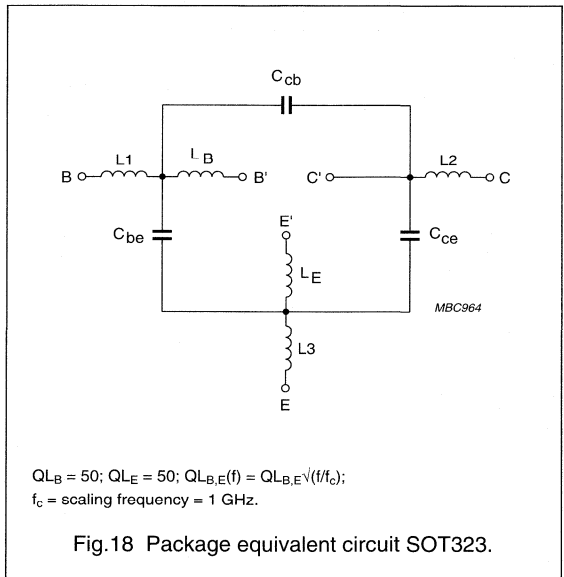


Fig. 18 Package equivalent circuit SOT323.

List of components (see Fig.18)

| DESIGNATION | VALUE | UNIT |
|-----------------|-------|------|
| C _{be} | 2 | fF |
| C _{cb} | 100 | fF |
| C _{ce} | 100 | fF |
| L1 | 0.34 | nH |
| L2 | 0.10 | nH |
| L3 | 0.34 | nH |
| L _B | 0.60 | nH |
| L _E | 0.60 | nH |

PNP 5 GHz wideband transistor

BFT93

DESCRIPTION

PNP transistor in a plastic SOT23 envelope.

It is primarily intended for use in RF wideband amplifiers, such as in aerial amplifiers, radar systems, oscilloscopes, spectrum analyzers, etc. The transistor features low intermodulation distortion and high power gain; due to its very high transition frequency, it also has excellent wideband properties and low noise up to high frequencies.

NPN complements are BFR93 and BFR93A.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: X1p | |
| 1 | base |
| 2 | emitter |
| 3 | collector |

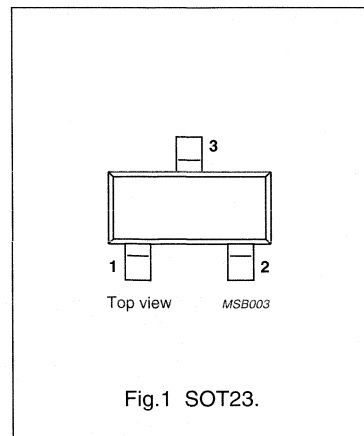


Fig.1 SOT23.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | TYP. | MAX. | UNIT |
|-----------|-------------------------------|--|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | –15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | –12 | V |
| I_C | DC collector current | | – | –35 | mA |
| P_{tot} | total power dissipation | up to $T_s = 95\text{ °C}$; note 1 | – | 300 | mW |
| f_T | transition frequency | $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 500\text{ MHz}$; $T_j = 25\text{ °C}$ | 5 | – | GHz |
| C_{re} | feedback capacitance | $I_C = -2\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 1\text{ MHz}$ | 1 | – | pF |
| G_{UM} | maximum unilateral power gain | $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 16.5 | – | dB |
| F | noise figure | $I_C = -10\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | 2.4 | – | dB |
| V_o | output voltage | $d_{im} = -60\text{ dB}$; $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$; $R_L = 75\text{ }\Omega$; $f_{(p+q-r)} = 493.25\text{ MHz}$ | 300 | – | mV |

Note

- T_s is the temperature at the soldering point of the collector tab.

PNP 5 GHz wideband transistor

BFT93

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-----------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | –15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | –12 | V |
| V_{EBO} | emitter-base voltage | open collector | – | –2 | V |
| I_C | DC collector current | | – | –35 | mA |
| I_{CM} | peak collector current | $f > 1$ MHz | – | –50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 95$ °C; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 175 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | CONDITIONS | THERMAL RESISTANCE |
|---------------|---|-------------------------------|--------------------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 70$ °C; (note 1) | 260 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

PNP 5 GHz wideband transistor

BFT93

CHARACTERISTICS $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0; V_{CB} = -5\text{ V}$ | – | – | –50 | nA |
| h_{FE} | DC current gain | $I_C = -30\text{ mA}; V_{CE} = -5\text{ V}$ | 20 | 50 | – | |
| f_T | transition frequency | $I_C = -30\text{ mA}; V_{CE} = -5\text{ V};$ $f = 500\text{ MHz}$ | – | 5 | – | GHz |
| C_c | collector capacitance | $I_E = i_e = 0; V_{CB} = -10\text{ V}; f = 1\text{ MHz}$ | – | 0.95 | – | pF |
| C_e | emitter capacitance | $I_c = i_c = 0; V_{EB} = -0.5\text{ V}; f = 1\text{ MHz}$ | – | 1.8 | – | pF |
| C_{re} | feedback capacitance | $I_C = -2\text{ mA}; V_{CE} = -5\text{ V}; f = 1\text{ MHz}$ | – | 1 | – | pF |
| G_{UM} | maximum unilateral power gain (note 1) | $I_C = -30\text{ mA}; V_{CE} = -5\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 16.5 | – | dB |
| F | noise figure | $I_C = -10\text{ mA}; V_{CE} = -5\text{ V};$ $f = 500\text{ MHz}; T_{amb} = 25\text{ }^\circ\text{C}$ | – | 2.4 | – | dB |
| V_o | output voltage | see Fig.2 and note 2 | – | 300 | – | mV |

Notes

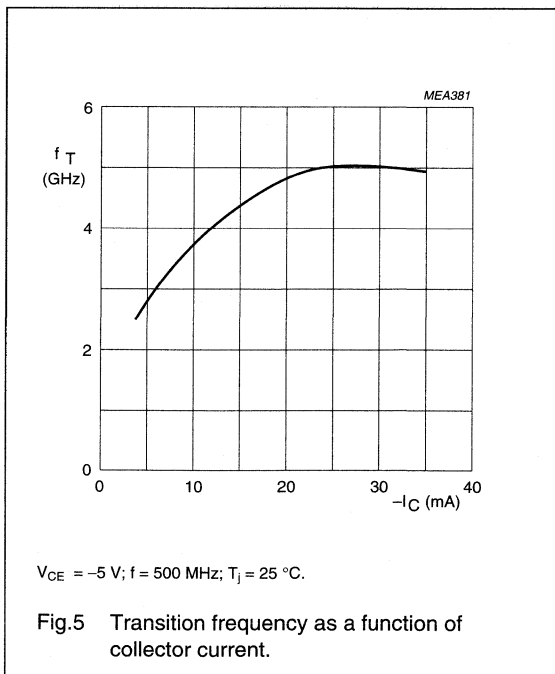
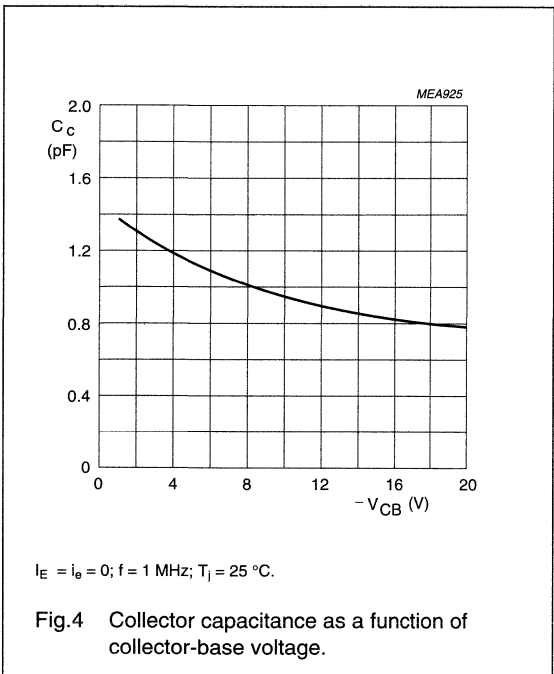
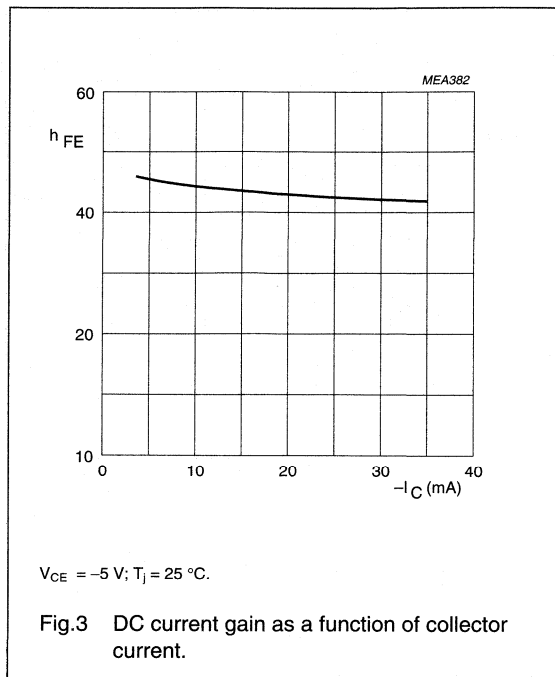
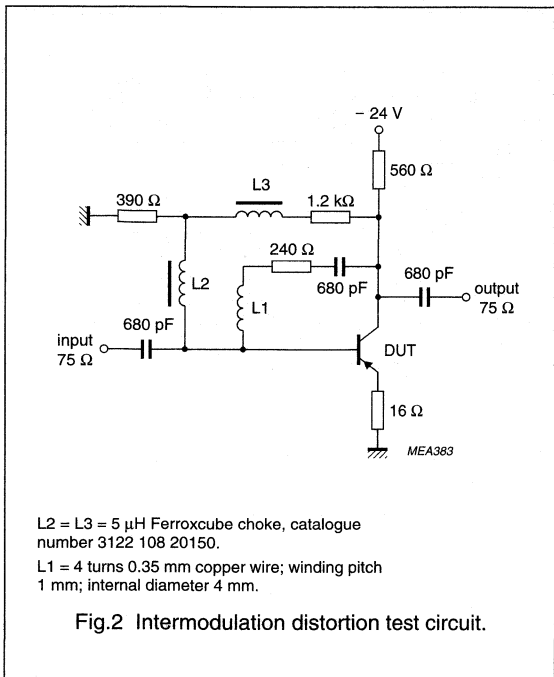
1. G_{UM} is the maximum unilateral power gain, assuming S_{12} is zero and

$$G_{UM} = 10 \log \left(\frac{|S_{21}|^2}{(1 - |S_{11}|^2)(1 - |S_{22}|^2)} \right) \text{dB.}$$

2. $d_{im} = -60\text{ dB}$ (DIN 45004B); $I_C = -30\text{ mA}; V_{CE} = -5\text{ V}; R_L = 75\ \Omega;$
 $V_p = V_o$ at $d_{im} = -60\text{ dB}; f_p = 495.25\text{ MHz};$
 $V_q = V_o - 6\text{ dB}; f_q = 503.25\text{ MHz};$
 $V_r = V_o - 6\text{ dB}; f_r = 505.25\text{ MHz};$
 measured at $f_{(p+q-r)} = 493.25\text{ MHz}.$

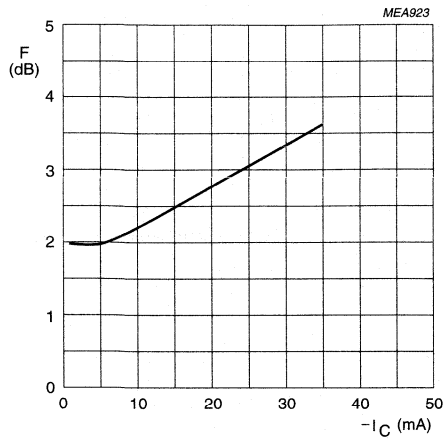
PNP 5 GHz wideband transistor

BFT93



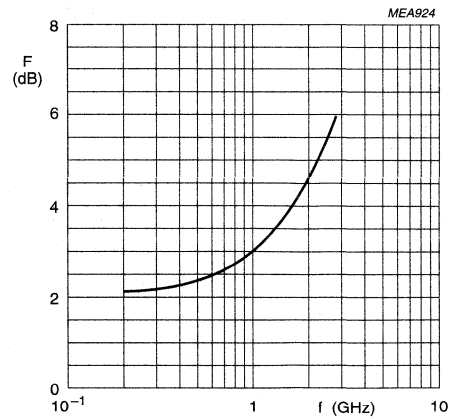
PNP 5 GHz wideband transistor

BFT93



$V_{CE} = -5$ V; $Z_s = \text{opt.}$; $f = 500$ MHz; $T_{\text{amb}} = 25$ °C.

Fig.6 Minimum noise figure as a function of collector current.



$I_C = -2$ mA; $V_{CE} = -5$ V; $Z_s = \text{opt.}$; $T_{\text{amb}} = 25$ °C.

Fig.7 Minimum noise figure as a function of frequency.

PNP 4 GHz wideband transistor

BFT93W

FEATURES

- High power gain
- Gold metallization ensures excellent reliability
- SOT323 (S-mini) package.

APPLICATIONS

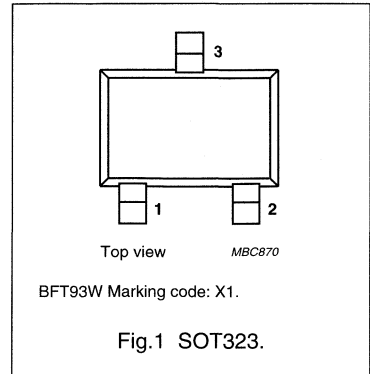
It is intended as a general purpose transistor for wideband applications up to 2 GHz.

DESCRIPTION

Silicon PNP transistor in a plastic, SOT323 (S-mini) package. The BFT93W uses the same crystal as the SOT23 version, BFT93.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | – | –15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | – | –12 | V |
| I_C | collector current (DC) | | – | – | –50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 93\text{ °C}$; note 1 | – | – | 300 | mW |
| h_{FE} | DC current gain | $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$ | 20 | 50 | – | |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = -5\text{ V}$; $f = 1\text{ MHz}$ | – | 1 | – | pF |
| f_T | transition frequency | $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 500\text{ MHz}$ | – | 4 | – | GHz |
| G_{UM} | maximum unilateral power gain | $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15.5 | – | dB |
| F | noise figure | $I_C = -10\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 500\text{ MHz}$ | – | 2.4 | – | dB |
| T_j | junction temperature | | – | – | 150 | °C |

Note

1. T_s is the temperature at the soldering point of the collector pin.

PNP 4 GHz wideband transistor

BFT93W

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | –15 | V |
| V_{CEO} | collector-emitter voltage | open base | – | –12 | V |
| V_{EBO} | emitter-base voltage | open collector | – | –2 | V |
| I_C | collector current (DC) | | – | –50 | mA |
| P_{tot} | total power dissipation | up to $T_s = 93\text{ °C}$; note 1 | – | 300 | mW |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | junction temperature | | – | 150 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|-------------------------------------|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | up to $T_s = 93\text{ °C}$; note 1 | 190 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ °C}$ (unless otherwise specified).

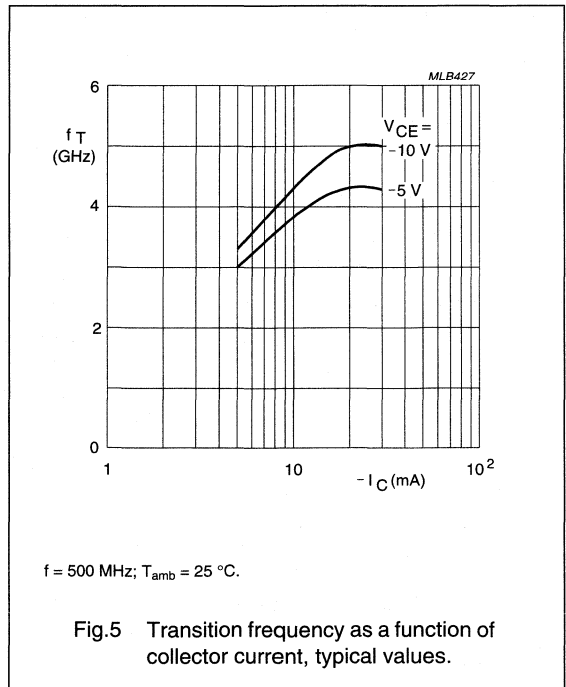
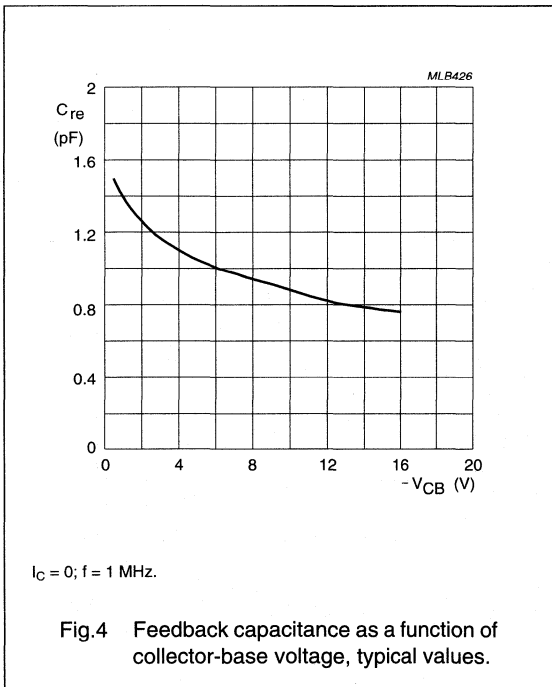
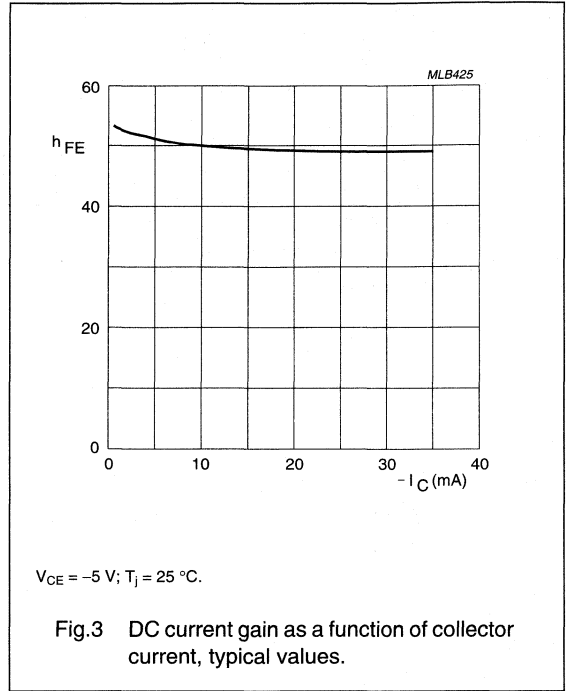
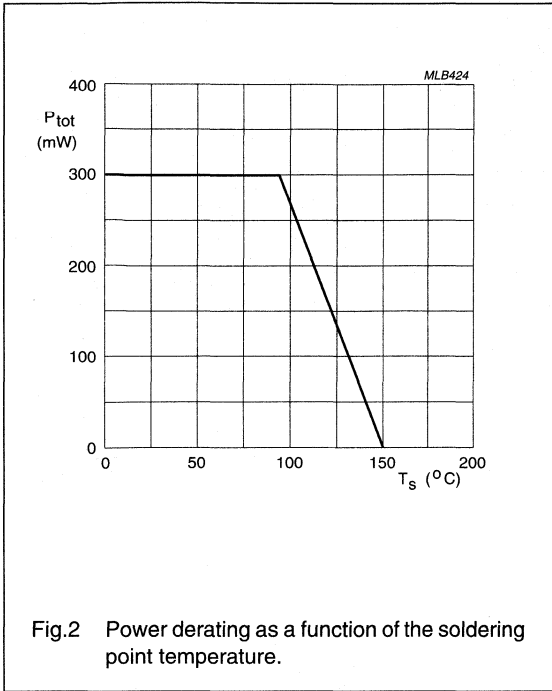
| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|-----------|---------------------------------------|--|------|------|------|------|
| I_{CBO} | collector cut-off current | $I_E = 0$; $V_{CB} = -5\text{ V}$ | – | – | –50 | nA |
| h_{FE} | DC current gain | $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$ | 20 | 50 | – | |
| f_T | transition frequency | $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 4 | – | GHz |
| C_c | collector capacitance | $I_E = i_e = 0$; $V_{CB} = -5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.2 | – | pF |
| C_e | emitter capacitance | $I_C = i_c = 0$; $V_{EB} = -0.5\text{ V}$; $f = 1\text{ MHz}$ | – | 1.4 | – | pF |
| C_{re} | feedback capacitance | $I_C = 0$; $V_{CE} = -5\text{ V}$; $f = 1\text{ MHz}$ | – | 1 | – | pF |
| G_{UM} | maximum unilateral power gain; note 1 | $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 500\text{ MHz}$; $T_{amb} = 25\text{ °C}$ | – | 15.5 | – | dB |
| | | $I_C = -30\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 1\text{ GHz}$; $T_{amb} = 25\text{ °C}$ | – | 10 | – | dB |
| F | noise figure | $\Gamma_s = \Gamma_{opt}$; $I_C = -10\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 500\text{ MHz}$ | – | 2.4 | – | dB |
| | | $\Gamma_s = \Gamma_{opt}$; $I_C = -10\text{ mA}$; $V_{CE} = -5\text{ V}$; $f = 1\text{ GHz}$ | – | 3 | – | dB |

Note

- G_{UM} is the maximum unilateral power gain, assuming s_{12} is zero. $G_{UM} = 10 \log \frac{|s_{21}|^2}{(1 - |s_{11}|^2)(1 - |s_{22}|^2)}$ dB.

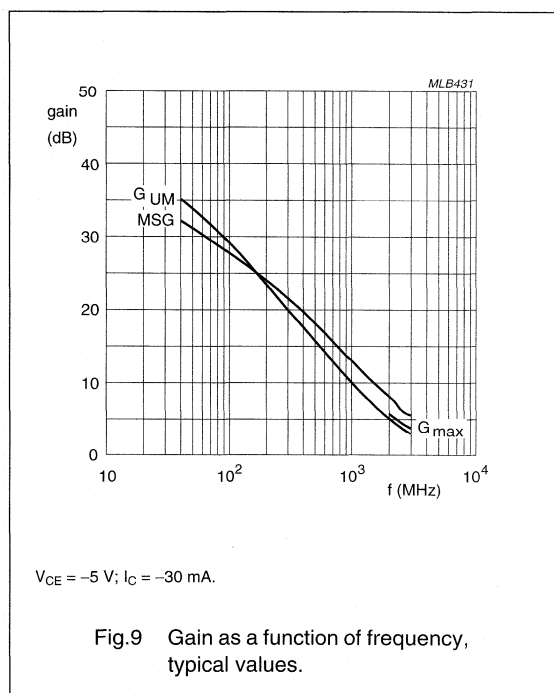
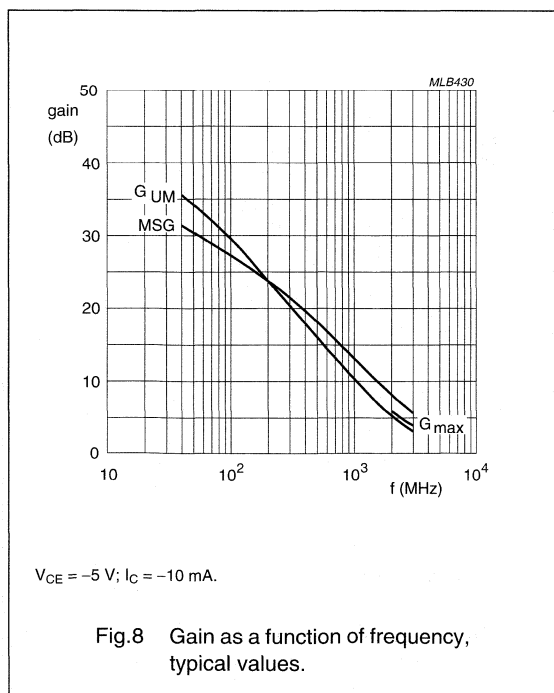
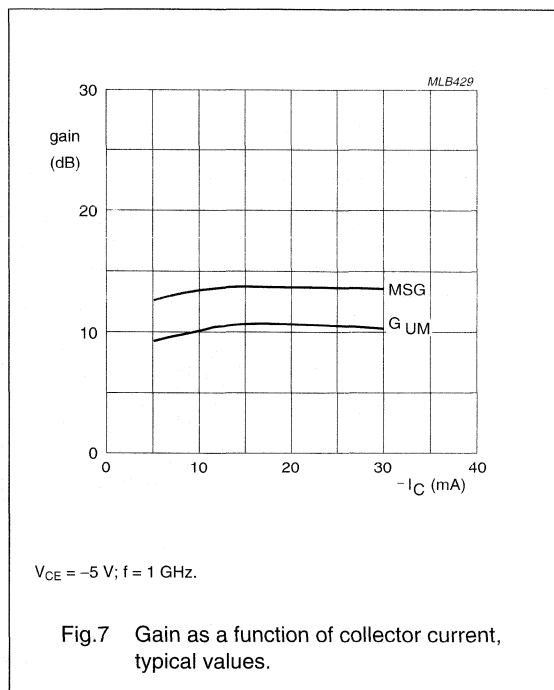
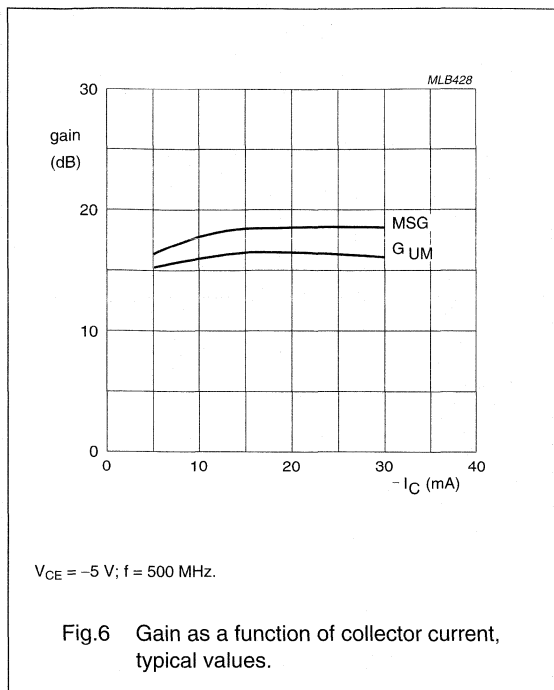
PNP 4 GHz wideband transistor

BFT93W



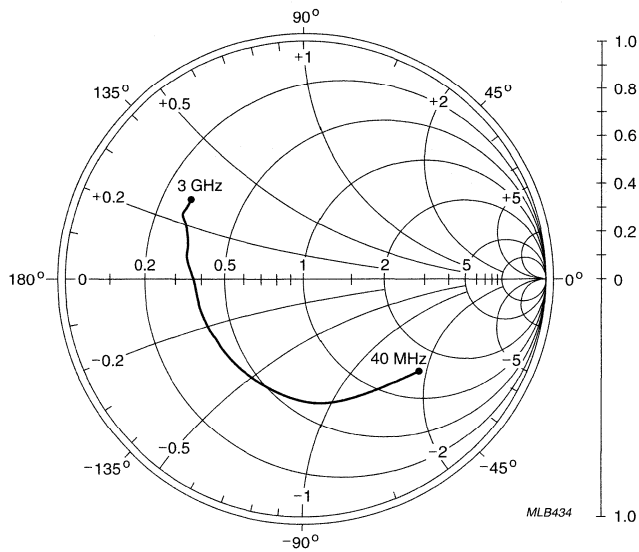
PNP 4 GHz wideband transistor

BFT93W



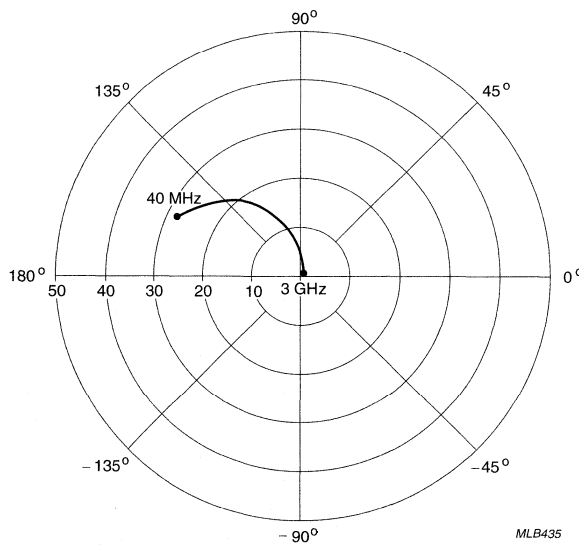
PNP 4 GHz wideband transistor

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$V_{CE} = -10\text{ V}; I_C = -30\text{ mA}$.

Fig.10 Common emitter input reflection coefficient (s_{11}), typical values.

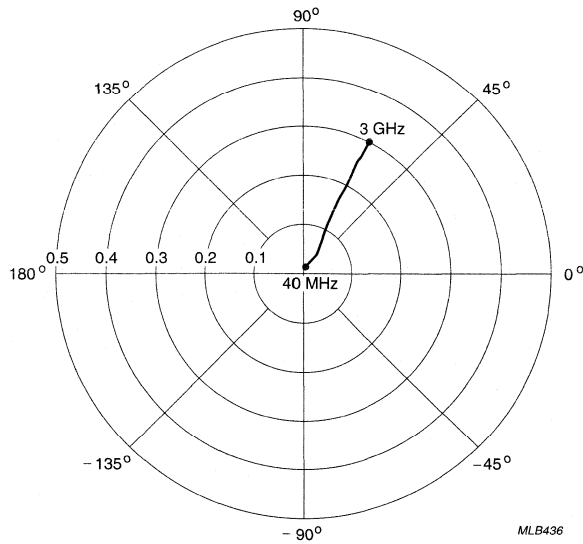


$V_{CE} = -10\text{ V}; I_C = -30\text{ mA}$.

Fig.11 Common emitter forward transmission coefficient (s_{21}), typical values.

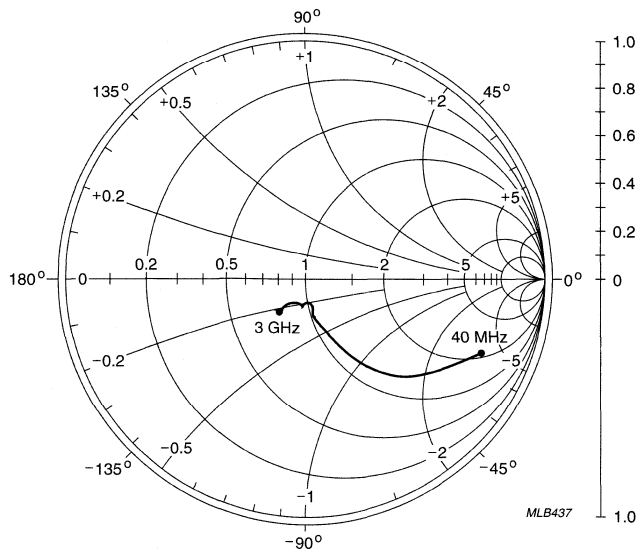
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$V_{CE} = -10\text{ V}; I_C = -30\text{ mA}$.

Fig.12 Common emitter reverse transmission coefficient (s_{12}), typical values.

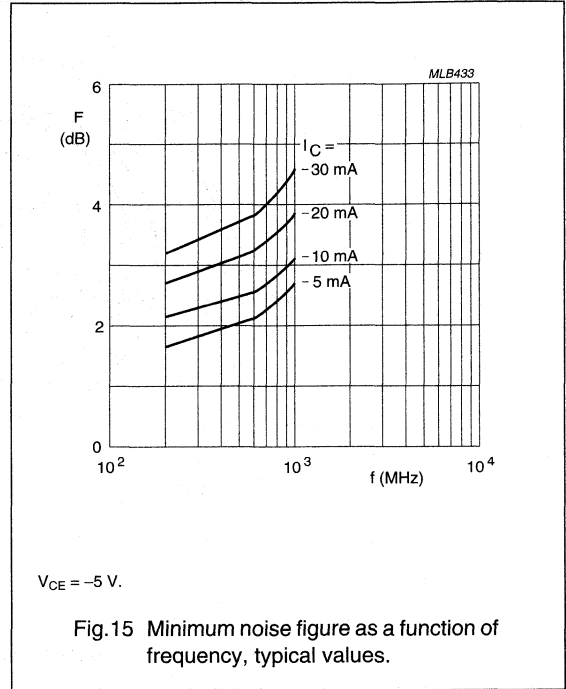
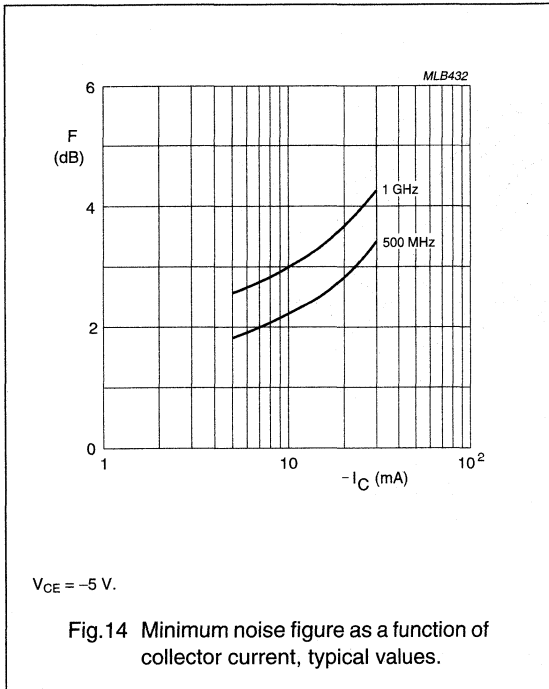


$V_{CE} = -10\text{ V}; I_C = -30\text{ mA}$.

Fig.13 Common emitter output reflection coefficient (s_{22}), typical values.

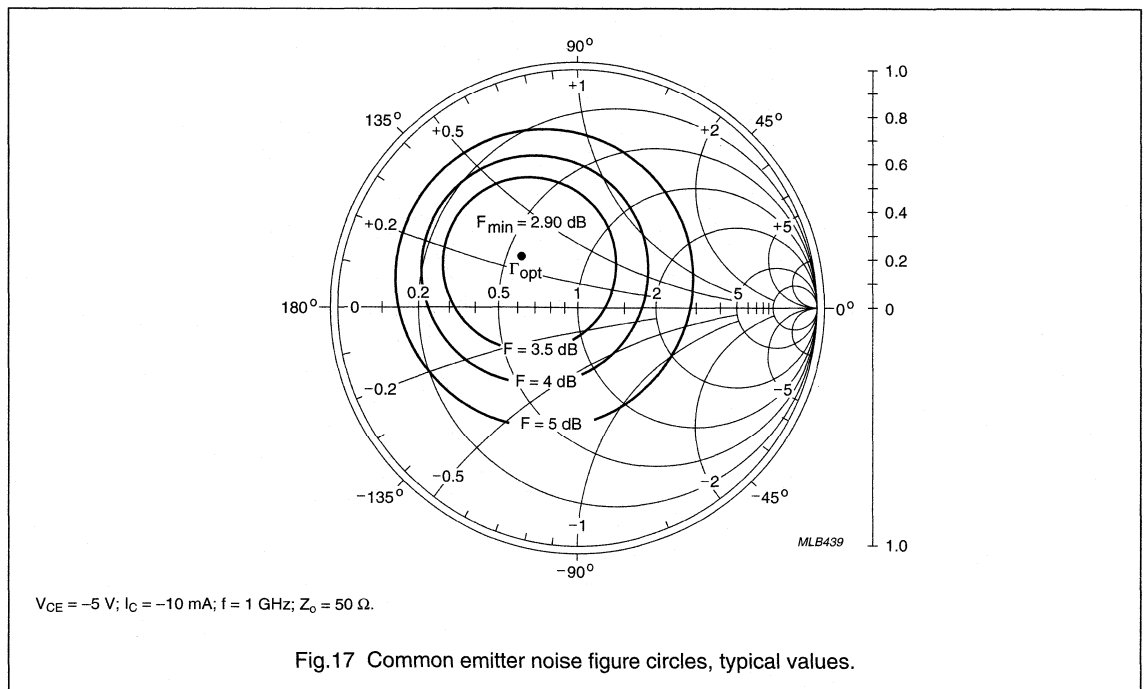
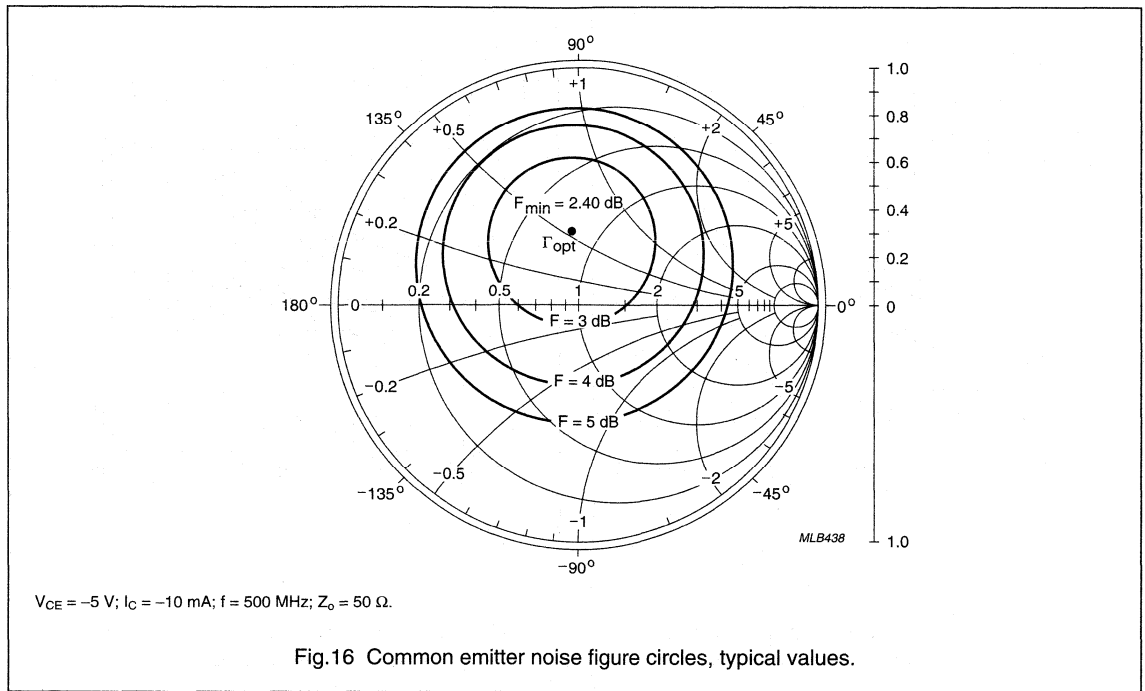
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SPICE parameters for the BFT93W crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------------|
| 1 | IS | 835.1 | aA |
| 2 | BF | 48.56 | – |
| 3 | NF | 1.000 | – |
| 4 | VAF | 19.01 | V |
| 5 | IKF | 146.8 | mA |
| 6 | ISE | 90.94 | fA |
| 7 | NE | 1.749 | – |
| 8 | BR | 12.18 | – |
| 9 | NR | 997.6 | m |
| 10 | VAR | 3.374 | V |
| 11 | IKR | 6.742 | mA |
| 12 | ISC | 23.42 | fA |
| 13 | NC | 1.449 | – |
| 14 | RB | 10.00 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 10.00 | Ω |
| 17 | RE | 200.0 | m Ω |
| 18 | RC | 3.800 | Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | – |
| 20 ⁽¹⁾ | EG | 1.110 | EV |
| 21 ⁽¹⁾ | XTI | 3.000 | – |
| 22 | CJE | 1.570 | pF |
| 23 | VJE | 600.0 | mV |
| 24 | MJE | 382.2 | m |
| 25 | TF | 14.85 | ps |
| 26 | XTF | 2.209 | – |
| 27 | VTF | 2.989 | V |
| 28 | ITF | 14.37 | mA |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 1.995 | pF |
| 31 | VJC | 584.4 | mV |
| 32 | MJC | 281.3 | m |
| 33 | XCJC | 120.0 | m |
| 34 | TR | 3.000 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------|
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | – |
| 38 | FC | 811.6 | m |

Note

1. These parameters have not been extracted, the default values are shown.

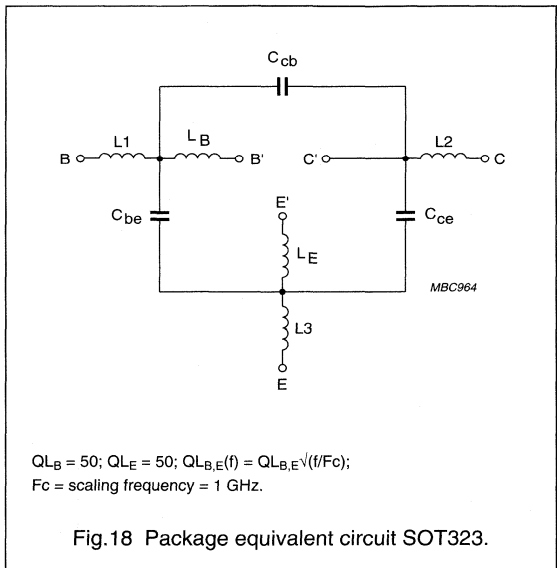


Fig.18 Package equivalent circuit SOT323.

List of components (see Fig.18).

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 2 | fF |
| C_{cb} | 100 | fF |
| C_{ce} | 100 | fF |
| L1 | 0.34 | nH |
| L2 | 0.10 | nH |
| L3 | 0.34 | nH |
| L_B | 0.60 | nH |
| L_E | 0.60 | nH |

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Table 1 Common emitter scattering parameters: $V_{CE} = -5$ V; $I_C = -5$ mA.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | | G _{UM} (dB) |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|-------------------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | |
| 40 | 0.759 | -20.5 | 11.294 | 165.0 | 0.023 | 78.5 | 0.945 | -12.3 | 34.5 |
| 100 | 0.711 | -49.0 | 10.079 | 147.7 | 0.050 | 64.5 | 0.834 | -27.8 | 28.3 |
| 200 | 0.630 | -88.0 | 8.082 | 126.7 | 0.076 | 51.2 | 0.631 | -44.0 | 22.5 |
| 300 | 0.586 | -113.6 | 6.355 | 113.1 | 0.090 | 45.1 | 0.491 | -52.8 | 19.1 |
| 400 | 0.566 | -130.5 | 5.116 | 104.1 | 0.099 | 42.9 | 0.403 | -58.5 | 16.6 |
| 500 | 0.557 | -141.8 | 4.266 | 97.5 | 0.107 | 42.8 | 0.349 | -62.5 | 14.8 |
| 600 | 0.551 | -150.5 | 3.653 | 92.2 | 0.113 | 43.7 | 0.316 | -65.2 | 13.3 |
| 700 | 0.546 | -157.1 | 3.193 | 87.7 | 0.120 | 44.9 | 0.293 | -66.8 | 12.0 |
| 800 | 0.543 | -162.7 | 2.838 | 83.9 | 0.127 | 46.2 | 0.277 | -67.7 | 10.9 |
| 900 | 0.541 | -167.6 | 2.551 | 80.4 | 0.133 | 47.6 | 0.263 | -68.1 | 9.9 |
| 1000 | 0.541 | -172.0 | 2.323 | 77.4 | 0.140 | 49.1 | 0.249 | -68.7 | 9.1 |
| 1200 | 0.549 | -179.4 | 1.975 | 71.7 | 0.153 | 51.6 | 0.223 | -71.8 | 7.7 |
| 1400 | 0.559 | 174.8 | 1.737 | 66.4 | 0.168 | 53.8 | 0.212 | -78.3 | 6.6 |
| 1600 | 0.565 | 170.3 | 1.555 | 61.7 | 0.183 | 55.2 | 0.215 | -84.5 | 5.7 |
| 1800 | 0.566 | 165.6 | 1.420 | 57.7 | 0.197 | 56.8 | 0.220 | -87.5 | 4.9 |
| 2000 | 0.575 | 160.5 | 1.310 | 54.2 | 0.213 | 58.3 | 0.215 | -91.0 | 4.3 |
| 2200 | 0.594 | 156.3 | 1.217 | 51.1 | 0.228 | 59.7 | 0.208 | -98.1 | 3.8 |
| 2400 | 0.613 | 153.7 | 1.135 | 47.7 | 0.242 | 60.6 | 0.217 | -107.7 | 3.4 |
| 2600 | 0.623 | 151.4 | 1.064 | 44.8 | 0.255 | 60.9 | 0.242 | -114.1 | 2.9 |
| 2800 | 0.618 | 148.2 | 1.019 | 41.7 | 0.271 | 61.5 | 0.264 | -116.9 | 2.6 |
| 3000 | 0.621 | 144.5 | 0.975 | 39.3 | 0.289 | 61.9 | 0.275 | -119.3 | 2.2 |

Table 2 Noise data: $V_{CE} = -5$ V; $I_C = -5$ mA.

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n |
|------------|--------------------------|------------------|-------|----------------|
| | | (ratio) | (deg) | |
| 500 | 1.80 | 0.307 | 86.5 | 0.320 |
| 1000 | 2.55 | 0.358 | 121.0 | 0.280 |

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Table 3 Common emitter scattering parameters: $V_{CE} = -5$ V; $I_C = -10$ mA.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | | G _{UM} (dB) |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|-------------------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | |
| 40 | 0.608 | -31.5 | 18.195 | 160.2 | 0.020 | 75.6 | 0.900 | -18.0 | 34.4 |
| 100 | 0.571 | -72.1 | 15.044 | 138.8 | 0.041 | 60.6 | 0.725 | -38.4 | 28.5 |
| 200 | 0.538 | -114.5 | 10.475 | 117.4 | 0.059 | 51.1 | 0.490 | -56.6 | 23.1 |
| 300 | 0.531 | -136.1 | 7.676 | 106.0 | 0.070 | 49.3 | 0.360 | -66.3 | 19.7 |
| 400 | 0.531 | -149.0 | 5.989 | 98.6 | 0.079 | 50.2 | 0.287 | -73.0 | 17.4 |
| 500 | 0.532 | -157.3 | 4.907 | 93.2 | 0.088 | 51.8 | 0.245 | -77.9 | 15.5 |
| 600 | 0.534 | -163.6 | 4.161 | 88.9 | 0.097 | 53.8 | 0.221 | -81.4 | 14.1 |
| 700 | 0.533 | -168.6 | 3.613 | 85.1 | 0.106 | 55.4 | 0.204 | -83.2 | 12.8 |
| 800 | 0.532 | -172.9 | 3.195 | 81.8 | 0.116 | 56.9 | 0.192 | -84.2 | 11.7 |
| 900 | 0.534 | -176.8 | 2.866 | 78.8 | 0.125 | 58.1 | 0.179 | -84.5 | 10.7 |
| 1000 | 0.535 | 179.7 | 2.603 | 76.2 | 0.135 | 59.3 | 0.167 | -85.3 | 9.9 |
| 1200 | 0.545 | 173.7 | 2.206 | 71.2 | 0.153 | 61.0 | 0.145 | -90.1 | 8.5 |
| 1400 | 0.557 | 169.2 | 1.931 | 66.6 | 0.172 | 62.0 | 0.140 | -98.7 | 7.4 |
| 1600 | 0.561 | 165.5 | 1.724 | 62.2 | 0.191 | 62.3 | 0.149 | -104.6 | 6.5 |
| 1800 | 0.563 | 161.2 | 1.570 | 58.5 | 0.208 | 62.7 | 0.154 | -106.3 | 5.7 |
| 2000 | 0.574 | 156.6 | 1.447 | 55.2 | 0.227 | 63.2 | 0.150 | -109.4 | 5.0 |
| 2200 | 0.593 | 153.0 | 1.343 | 52.4 | 0.244 | 63.7 | 0.148 | -117.9 | 4.5 |
| 2400 | 0.612 | 150.6 | 1.251 | 49.2 | 0.260 | 64.0 | 0.165 | -127.5 | 4.1 |
| 2600 | 0.620 | 148.8 | 1.171 | 46.3 | 0.274 | 63.5 | 0.192 | -131.8 | 3.6 |
| 2800 | 0.616 | 146.0 | 1.122 | 43.2 | 0.290 | 63.3 | 0.213 | -132.1 | 3.3 |
| 3000 | 0.618 | 142.3 | 1.074 | 40.7 | 0.309 | 63.2 | 0.223 | -133.3 | 2.9 |

Table 4 Noise data: $V_{CE} = -5$ V; $I_C = -10$ mA.

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n |
|------------|--------------------------|------------------|-------|----------------|
| | | (ratio) | (deg) | |
| 500 | 2.40 | 0.304 | 94.7 | 0.430 |
| 1000 | 2.90 | 0.321 | 136.9 | 0.270 |

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Table 5 Common emitter scattering parameters: $V_{CE} = -5$ V; $I_C = -20$ mA.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | | G _{UM} (dB) |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|-------------------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | |
| 40 | 0.450 | -49.1 | 25.274 | 154.6 | 0.018 | 72.5 | 0.830 | -24.1 | 34.1 |
| 100 | 0.475 | -99.1 | 18.682 | 130.2 | 0.034 | 59.2 | 0.608 | -47.9 | 28.5 |
| 200 | 0.502 | -135.9 | 11.661 | 110.7 | 0.047 | 54.5 | 0.379 | -67.2 | 23.3 |
| 300 | 0.516 | -151.8 | 8.244 | 101.0 | 0.058 | 55.6 | 0.270 | -77.9 | 20.0 |
| 400 | 0.526 | -161.1 | 6.342 | 94.7 | 0.068 | 58.1 | 0.215 | -86.1 | 17.7 |
| 500 | 0.530 | -167.1 | 5.156 | 90.2 | 0.079 | 60.1 | 0.185 | -92.5 | 15.8 |
| 600 | 0.534 | -171.9 | 4.350 | 86.3 | 0.089 | 61.9 | 0.169 | -96.7 | 14.4 |
| 700 | 0.535 | -175.7 | 3.768 | 83.0 | 0.101 | 63.2 | 0.157 | -98.7 | 13.1 |
| 800 | 0.536 | -179.1 | 3.326 | 80.1 | 0.112 | 64.0 | 0.147 | -99.8 | 12.0 |
| 900 | 0.538 | 177.7 | 2.980 | 77.3 | 0.123 | 64.8 | 0.137 | -100.5 | 11.1 |
| 1000 | 0.541 | 174.9 | 2.703 | 74.9 | 0.134 | 65.4 | 0.127 | -101.9 | 10.2 |
| 1200 | 0.554 | 169.8 | 2.285 | 70.3 | 0.154 | 66.2 | 0.111 | -109.1 | 8.8 |
| 1400 | 0.566 | 166.1 | 1.995 | 65.9 | 0.175 | 66.6 | 0.112 | -118.8 | 7.7 |
| 1600 | 0.571 | 162.6 | 1.777 | 61.7 | 0.195 | 66.0 | 0.125 | -122.9 | 6.8 |
| 1800 | 0.573 | 158.8 | 1.616 | 58.2 | 0.214 | 66.0 | 0.130 | -123.1 | 6.0 |
| 2000 | 0.585 | 154.4 | 1.488 | 55.0 | 0.234 | 66.1 | 0.127 | -126.2 | 5.3 |
| 2200 | 0.604 | 151.0 | 1.380 | 52.4 | 0.252 | 66.2 | 0.130 | -135.1 | 4.8 |
| 2400 | 0.624 | 148.8 | 1.285 | 49.4 | 0.268 | 66.2 | 0.152 | -143.0 | 4.4 |
| 2600 | 0.633 | 147.1 | 1.200 | 46.6 | 0.282 | 65.5 | 0.180 | -144.7 | 3.9 |
| 2800 | 0.626 | 144.3 | 1.148 | 43.5 | 0.299 | 65.0 | 0.199 | -143.3 | 3.5 |
| 3000 | 0.629 | 140.8 | 1.100 | 41.0 | 0.319 | 64.7 | 0.208 | -143.7 | 3.2 |

Table 6 Noise data: $V_{CE} = -5$ V; $I_C = -20$ mA.

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n |
|------------|--------------------------|------------------|-------|----------------|
| | | (ratio) | (deg) | |
| 500 | 2.80 | 0.301 | 100.8 | 0.610 |
| 1000 | 3.60 | 0.356 | 152.2 | 0.280 |

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Table 7 Common emitter scattering parameters: $V_{CE} = -5$ V; $I_C = -30$ mA.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | | G _{UM} (dB) |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|-------------------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | |
| 40 | 0.382 | -62.3 | 28.063 | 151.4 | 0.016 | 71.2 | 0.781 | -27.1 | 33.7 |
| 100 | 0.453 | -113.1 | 19.479 | 126.1 | 0.030 | 58.8 | 0.543 | -51.8 | 28.3 |
| 200 | 0.502 | -144.8 | 11.682 | 107.7 | 0.043 | 56.8 | 0.327 | -70.7 | 23.1 |
| 300 | 0.521 | -158.0 | 8.162 | 98.8 | 0.054 | 58.9 | 0.232 | -81.5 | 19.8 |
| 400 | 0.532 | -165.8 | 6.248 | 92.9 | 0.065 | 61.4 | 0.185 | -89.9 | 17.5 |
| 500 | 0.537 | -170.8 | 5.069 | 88.6 | 0.076 | 63.4 | 0.161 | -96.5 | 15.7 |
| 600 | 0.542 | -174.9 | 4.269 | 84.9 | 0.088 | 65.0 | 0.148 | -100.5 | 14.2 |
| 700 | 0.543 | -178.2 | 3.692 | 81.7 | 0.099 | 65.8 | 0.139 | -102.3 | 13.0 |
| 800 | 0.545 | 178.7 | 3.258 | 78.8 | 0.111 | 66.4 | 0.131 | -103.2 | 11.9 |
| 900 | 0.548 | 176.0 | 2.917 | 76.1 | 0.122 | 67.0 | 0.123 | -103.6 | 10.9 |
| 1000 | 0.552 | 173.2 | 2.644 | 73.8 | 0.133 | 67.4 | 0.114 | -104.8 | 10.1 |
| 1200 | 0.565 | 168.6 | 2.233 | 69.2 | 0.154 | 68.0 | 0.101 | -112.5 | 8.7 |
| 1400 | 0.577 | 165.0 | 1.948 | 64.9 | 0.175 | 68.2 | 0.105 | -121.9 | 7.6 |
| 1600 | 0.584 | 161.7 | 1.734 | 60.8 | 0.195 | 67.5 | 0.119 | -125.4 | 6.7 |
| 1800 | 0.586 | 157.9 | 1.577 | 57.3 | 0.214 | 67.3 | 0.125 | -125.0 | 5.8 |
| 2000 | 0.598 | 153.6 | 1.451 | 54.2 | 0.234 | 67.3 | 0.124 | -128.3 | 5.2 |
| 2200 | 0.620 | 150.3 | 1.345 | 51.5 | 0.252 | 67.5 | 0.129 | -137.0 | 4.8 |
| 2400 | 0.639 | 148.1 | 1.251 | 48.7 | 0.269 | 67.5 | 0.152 | -144.6 | 4.3 |
| 2600 | 0.646 | 146.3 | 1.169 | 46.0 | 0.284 | 66.6 | 0.181 | -146.1 | 3.8 |
| 2800 | 0.642 | 143.4 | 1.118 | 43.0 | 0.300 | 66.2 | 0.200 | -144.7 | 3.4 |
| 3000 | 0.644 | 139.8 | 1.071 | 40.5 | 0.321 | 65.7 | 0.210 | -145.0 | 3.1 |

Table 8 Noise data: $V_{CE} = -5$ V; $I_C = -30$ mA.

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n |
|------------|--------------------------|------------------|-------|----------------|
| | | (ratio) | (deg) | |
| 500 | 3.40 | 0.308 | 104.2 | 0.830 |
| 1000 | 4.20 | 0.380 | 164.0 | 0.310 |

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Table 9 Common emitter scattering parameters: $V_{CE} = -10$ V; $I_C = -5$ mA.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | | G _{UM} (dB) |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|-------------------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | |
| 40 | 0.837 | -16.8 | 11.098 | 166.4 | 0.020 | 80.4 | 0.947 | -10.2 | 36.0 |
| 100 | 0.781 | -40.2 | 10.061 | 150.4 | 0.046 | 67.6 | 0.856 | -23.6 | 29.9 |
| 200 | 0.670 | -73.9 | 8.331 | 130.4 | 0.073 | 54.7 | 0.674 | -38.2 | 23.6 |
| 300 | 0.592 | -98.6 | 6.727 | 116.7 | 0.088 | 48.3 | 0.537 | -46.3 | 19.9 |
| 400 | 0.547 | -116.1 | 5.490 | 107.3 | 0.098 | 45.8 | 0.447 | -51.2 | 17.3 |
| 500 | 0.523 | -128.7 | 4.616 | 100.5 | 0.106 | 45.2 | 0.389 | -54.5 | 15.4 |
| 600 | 0.507 | -138.6 | 3.971 | 94.9 | 0.114 | 45.6 | 0.352 | -56.5 | 13.8 |
| 700 | 0.495 | -146.1 | 3.476 | 90.3 | 0.121 | 46.4 | 0.327 | -57.6 | 12.5 |
| 800 | 0.487 | -152.5 | 3.094 | 86.3 | 0.129 | 47.3 | 0.309 | -58.0 | 11.4 |
| 900 | 0.481 | -158.1 | 2.782 | 82.6 | 0.136 | 48.2 | 0.294 | -57.8 | 10.4 |
| 1000 | 0.478 | -163.1 | 2.532 | 79.5 | 0.143 | 49.3 | 0.279 | -57.8 | 9.5 |
| 1200 | 0.483 | -171.8 | 2.155 | 73.7 | 0.156 | 51.0 | 0.250 | -59.2 | 8.1 |
| 1400 | 0.493 | -178.2 | 1.895 | 68.4 | 0.171 | 52.4 | 0.234 | -63.8 | 7.0 |
| 1600 | 0.499 | 176.9 | 1.694 | 63.6 | 0.185 | 53.2 | 0.232 | -69.2 | 6.1 |
| 1800 | 0.501 | 172.0 | 1.541 | 59.6 | 0.198 | 54.4 | 0.233 | -71.8 | 5.3 |
| 2000 | 0.509 | 166.5 | 1.418 | 55.9 | 0.212 | 55.5 | 0.227 | -74.1 | 4.6 |
| 2200 | 0.529 | 161.8 | 1.317 | 52.6 | 0.224 | 56.5 | 0.215 | -79.5 | 4.0 |
| 2400 | 0.550 | 158.8 | 1.228 | 49.0 | 0.236 | 57.2 | 0.215 | -88.7 | 3.6 |
| 2600 | 0.564 | 156.7 | 1.148 | 45.9 | 0.246 | 57.5 | 0.232 | -96.4 | 3.1 |
| 2800 | 0.564 | 153.7 | 1.100 | 42.8 | 0.259 | 58.2 | 0.253 | -100.1 | 2.8 |
| 3000 | 0.569 | 150.0 | 1.051 | 40.2 | 0.274 | 58.9 | 0.262 | -102.7 | 2.4 |

Table 10 Noise data: $V_{CE} = -10$ V; $I_C = -5$ mA.

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n |
|------------|--------------------------|------------------|-------|----------------|
| | | (ratio) | (deg) | |
| 500 | 2.00 | 0.340 | 73.0 | 0.440 |
| 1000 | 2.50 | 0.380 | 105.0 | 0.360 |

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Table 11 Common emitter scattering parameters: $V_{CE} = -10$ V; $I_C = -10$ mA.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | | G _{UM} (dB) |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|-------------------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | |
| 40 | 0.744 | -24.2 | 18.034 | 162.0 | 0.019 | 77.2 | 0.902 | -15.2 | 35.9 |
| 100 | 0.666 | -56.4 | 15.339 | 142.3 | 0.040 | 63.6 | 0.757 | -33.0 | 30.0 |
| 200 | 0.556 | -95.4 | 11.171 | 121.0 | 0.059 | 53.5 | 0.533 | -49.6 | 24.0 |
| 300 | 0.507 | -119.1 | 8.353 | 109.0 | 0.071 | 50.8 | 0.398 | -57.9 | 20.5 |
| 400 | 0.485 | -134.4 | 6.576 | 101.2 | 0.081 | 51.0 | 0.319 | -63.2 | 18.0 |
| 500 | 0.474 | -144.5 | 5.412 | 95.6 | 0.090 | 52.2 | 0.272 | -66.9 | 16.1 |
| 600 | 0.469 | -152.4 | 4.597 | 91.1 | 0.099 | 53.7 | 0.243 | -69.2 | 14.6 |
| 700 | 0.465 | -158.4 | 3.997 | 87.2 | 0.108 | 54.9 | 0.224 | -70.3 | 13.3 |
| 800 | 0.461 | -163.5 | 3.537 | 83.9 | 0.118 | 56.1 | 0.209 | -70.3 | 12.2 |
| 900 | 0.459 | -168.1 | 3.170 | 80.8 | 0.128 | 57.0 | 0.196 | -69.7 | 11.2 |
| 1000 | 0.460 | -172.3 | 2.875 | 78.2 | 0.137 | 57.8 | 0.183 | -69.3 | 10.4 |
| 1200 | 0.469 | -179.3 | 2.435 | 73.1 | 0.155 | 59.1 | 0.157 | -71.0 | 8.9 |
| 1400 | 0.482 | 175.4 | 2.130 | 68.4 | 0.173 | 59.8 | 0.144 | -77.4 | 7.8 |
| 1600 | 0.488 | 171.5 | 1.898 | 64.1 | 0.191 | 59.7 | 0.147 | -83.7 | 6.8 |
| 1800 | 0.489 | 167.2 | 1.723 | 60.4 | 0.207 | 59.9 | 0.150 | -85.2 | 6.0 |
| 2000 | 0.501 | 162.2 | 1.584 | 57.0 | 0.224 | 60.3 | 0.144 | -87.1 | 5.3 |
| 2200 | 0.522 | 158.0 | 1.469 | 54.0 | 0.239 | 60.6 | 0.134 | -94.3 | 4.8 |
| 2400 | 0.543 | 155.4 | 1.367 | 50.7 | 0.253 | 60.7 | 0.140 | -106.3 | 4.3 |
| 2600 | 0.557 | 153.8 | 1.278 | 47.8 | 0.264 | 60.3 | 0.162 | -113.7 | 3.9 |
| 2800 | 0.556 | 151.0 | 1.222 | 44.7 | 0.278 | 60.4 | 0.183 | -115.3 | 3.5 |
| 3000 | 0.560 | 147.6 | 1.168 | 42.1 | 0.295 | 60.4 | 0.192 | -116.6 | 3.1 |

Table 12 Noise data: $V_{CE} = -10$ V; $I_C = -10$ mA.

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n |
|------------|--------------------------|------------------|-------|----------------|
| | | (ratio) | (deg) | |
| 500 | 2.40 | 0.270 | 83.0 | 0.400 |
| 1000 | 2.90 | 0.350 | 115.0 | 0.350 |

PNP 4 GHz wideband transistor

BFT93W

Table 13 Common emitter scattering parameters: $V_{CE} = -10$ V; $I_C = -20$ mA.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | | G _{UM} (dB) |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|-------------------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | |
| 40 | 0.655 | -33.6 | 25.207 | 156.9 | 0.018 | 74.2 | 0.840 | -20.3 | 35.8 |
| 100 | 0.568 | -73.8 | 19.459 | 133.9 | 0.035 | 61.0 | 0.644 | -41.3 | 29.8 |
| 200 | 0.487 | -113.4 | 12.634 | 113.7 | 0.050 | 54.9 | 0.416 | -58.0 | 24.0 |
| 300 | 0.463 | -134.1 | 9.050 | 103.5 | 0.061 | 55.1 | 0.299 | -66.3 | 20.6 |
| 400 | 0.456 | -146.7 | 6.997 | 96.9 | 0.072 | 56.9 | 0.236 | -72.0 | 18.2 |
| 500 | 0.453 | -154.7 | 5.702 | 92.1 | 0.082 | 58.5 | 0.200 | -76.3 | 16.3 |
| 600 | 0.453 | -161.0 | 4.818 | 88.2 | 0.093 | 60.0 | 0.179 | -79.0 | 14.8 |
| 700 | 0.451 | -165.7 | 4.171 | 84.8 | 0.104 | 61.0 | 0.165 | -79.9 | 13.5 |
| 800 | 0.451 | -169.9 | 3.683 | 81.8 | 0.115 | 61.8 | 0.155 | -79.9 | 12.4 |
| 900 | 0.452 | -173.7 | 3.297 | 79.0 | 0.126 | 62.4 | 0.143 | -79.0 | 11.4 |
| 1000 | 0.454 | -177.3 | 2.986 | 76.6 | 0.137 | 62.9 | 0.132 | -78.5 | 10.6 |
| 1200 | 0.467 | 176.6 | 2.521 | 71.9 | 0.157 | 63.4 | 0.110 | -81.6 | 9.2 |
| 1400 | 0.482 | 172.4 | 2.200 | 67.6 | 0.176 | 63.4 | 0.103 | -90.5 | 8.0 |
| 1600 | 0.490 | 168.8 | 1.956 | 63.6 | 0.195 | 62.8 | 0.110 | -97.4 | 7.1 |
| 1800 | 0.493 | 164.8 | 1.774 | 60.1 | 0.212 | 62.7 | 0.114 | -98.0 | 6.2 |
| 2000 | 0.505 | 159.8 | 1.630 | 56.8 | 0.230 | 62.7 | 0.109 | -100.1 | 5.6 |
| 2200 | 0.528 | 155.9 | 1.509 | 54.1 | 0.245 | 62.8 | 0.103 | -109.7 | 5.0 |
| 2400 | 0.550 | 153.6 | 1.405 | 51.0 | 0.260 | 62.7 | 0.115 | -122.8 | 4.6 |
| 2600 | 0.563 | 151.9 | 1.312 | 48.1 | 0.273 | 62.2 | 0.141 | -128.2 | 4.1 |
| 2800 | 0.562 | 149.2 | 1.253 | 45.2 | 0.287 | 62.0 | 0.160 | -127.8 | 3.7 |
| 3000 | 0.565 | 145.8 | 1.199 | 42.6 | 0.305 | 61.7 | 0.169 | -128.3 | 3.4 |

Table 14 Noise data: $V_{CE} = -10$ V; $I_C = -20$ mA.

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n |
|------------|--------------------------|------------------|-------|----------------|
| | | (ratio) | (deg) | |
| 500 | 3.00 | 0.240 | 98.0 | 0.440 |
| 1000 | 3.60 | 0.320 | 131.0 | 0.400 |

PNP 4 GHz wideband transistor

BFT93W

Table 15 Common emitter scattering parameters: $V_{CE} = -10$ V; $I_C = -30$ mA.

| f (MHz) | S ₁₁ | | S ₂₁ | | S ₁₂ | | S ₂₂ | | G _{UM} (dB) |
|------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|----------------------|----------------|-------------------------|
| | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | MAGNITUDE (ratio) | ANGLE (deg) | |
| 40 | 0.617 | -39.1 | 28.045 | 153.9 | 0.017 | 73.1 | 0.797 | -22.6 | 35.4 |
| 100 | 0.529 | -82.4 | 20.389 | 129.6 | 0.032 | 60.3 | 0.583 | -44.1 | 29.4 |
| 200 | 0.464 | -120.8 | 12.630 | 110.4 | 0.047 | 56.4 | 0.364 | -59.3 | 23.7 |
| 300 | 0.449 | -139.7 | 8.920 | 101.0 | 0.058 | 57.3 | 0.259 | -66.3 | 20.3 |
| 400 | 0.446 | -151.0 | 6.853 | 94.8 | 0.069 | 59.4 | 0.204 | -71.2 | 17.9 |
| 500 | 0.446 | -158.1 | 5.569 | 90.3 | 0.081 | 60.9 | 0.174 | -75.0 | 16.0 |
| 600 | 0.448 | -163.5 | 4.694 | 86.5 | 0.092 | 62.2 | 0.158 | -77.2 | 14.5 |
| 700 | 0.449 | -167.8 | 4.060 | 83.3 | 0.103 | 63.0 | 0.147 | -77.7 | 13.2 |
| 800 | 0.450 | -171.7 | 3.579 | 80.4 | 0.115 | 63.6 | 0.139 | -77.1 | 12.1 |
| 900 | 0.452 | -175.1 | 3.204 | 77.7 | 0.126 | 63.8 | 0.131 | -75.9 | 11.2 |
| 1000 | 0.456 | -178.5 | 2.902 | 75.4 | 0.136 | 64.1 | 0.122 | -75.0 | 10.3 |
| 1200 | 0.472 | 175.9 | 2.448 | 70.8 | 0.157 | 64.3 | 0.103 | -77.7 | 8.9 |
| 1400 | 0.488 | 171.7 | 2.134 | 66.6 | 0.176 | 64.2 | 0.097 | -87.1 | 7.8 |
| 1600 | 0.498 | 168.1 | 1.898 | 62.5 | 0.194 | 63.6 | 0.106 | -94.6 | 6.9 |
| 1800 | 0.502 | 164.0 | 1.721 | 59.1 | 0.211 | 63.4 | 0.112 | -95.7 | 6.0 |
| 2000 | 0.516 | 159.3 | 1.580 | 56.0 | 0.229 | 63.5 | 0.108 | -98.0 | 5.4 |
| 2200 | 0.539 | 155.4 | 1.464 | 53.2 | 0.245 | 63.7 | 0.103 | -108.1 | 4.8 |
| 2400 | 0.562 | 152.9 | 1.362 | 50.2 | 0.260 | 63.6 | 0.116 | -121.5 | 4.4 |
| 2600 | 0.575 | 151.2 | 1.273 | 47.4 | 0.272 | 63.0 | 0.141 | -127.4 | 3.9 |
| 2800 | 0.573 | 148.4 | 1.217 | 44.5 | 0.287 | 62.9 | 0.162 | -127.3 | 3.5 |
| 3000 | 0.576 | 144.7 | 1.164 | 42.0 | 0.305 | 62.6 | 0.172 | -128.1 | 3.2 |

Table 16 Noise data: $V_{CE} = -10$ V; $I_C = -30$ mA.

| f (MHz) | F _{min} (dB) | Γ _{opt} | | R _n |
|------------|--------------------------|------------------|-------|----------------|
| | | (ratio) | (deg) | |
| 500 | 3.60 | 0.250 | 101.0 | 0.550 |
| 1000 | 4.20 | 0.310 | 143.0 | 0.480 |

UHF power transistor

BLT70

FEATURES

- Very high efficiency
- Low supply voltage.

APPLICATIONS

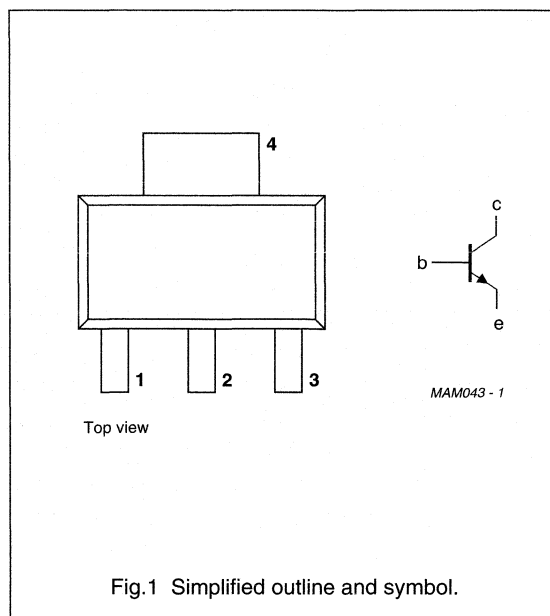
- Hand-held radio equipment in common emitter class-AB operation in the 900 MHz communication band.

DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a plastic SOT223H SMD package.

PINNING - SOT223H

| PIN | SYMBOL | DESCRIPTION |
|-----|--------|-------------|
| 1 | e | emitter |
| 2 | b | base |
| 3 | e | emitter |
| 4 | c | collector |



QUICK REFERENCE DATA

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit (see Fig.7).

| MODE OF OPERATION | f (MHz) | V_{CE} (V) | P_L (mW) | G_p (dB) | η_c (%) |
|-------------------|------------|-----------------|---------------|---------------|-----------------|
| CW, class-AB | 900 | 4.8 | 600 | >6 | ≥60 |

UHF power transistor

BLT70

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|---|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 16 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 250 | mA |
| P_{tot} | total power dissipation | $T_s = 60\text{ }^\circ\text{C}$; note 1 | – | 2.1 | W |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | operating junction temperature | | – | 175 | $^\circ\text{C}$ |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|-------------|---|--|-------|------|
| R_{thj-s} | thermal resistance from junction to soldering point | $P_{tot} = 2.1\text{ W}$; $T_s = 60\text{ }^\circ\text{C}$; note 1 | 55 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.

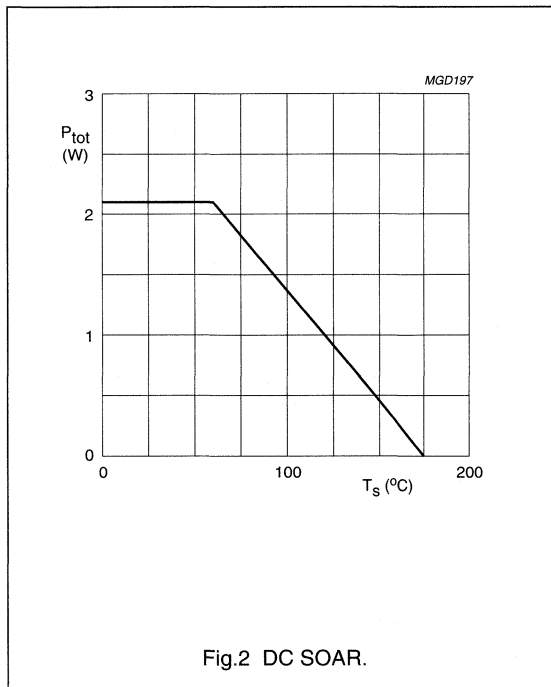


Fig.2 DC SOAR.

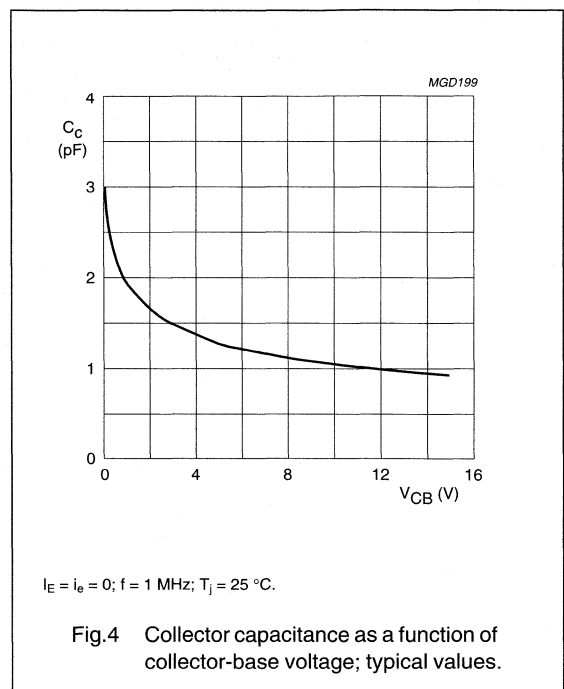
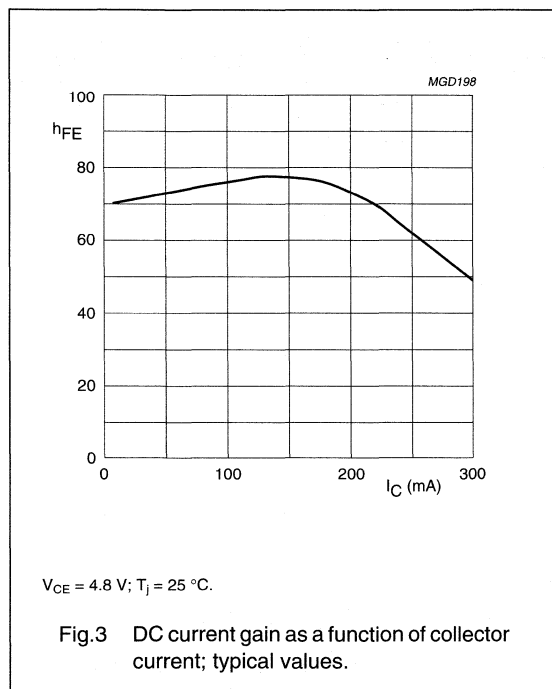
UHF power transistor

BLT70

CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 0.5\text{ mA}$ | 16 | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 5\text{ mA}$ | 8 | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.2\text{ mA}$ | 2.5 | – | V |
| I_{CES} | collector leakage current | $V_{CE} = 7\text{ V}$; $V_{BE} = 0$ | – | 0.1 | mA |
| h_{FE} | DC current gain | $V_{CE} = 4.8\text{ V}$; $I_C = 100\text{ mA}$ | 25 | – | |
| C_C | collector capacitance | $V_{CB} = 4.8\text{ V}$; $I_E = i_e = 0$; $f = 1\text{ MHz}$ | – | 3.5 | pF |
| C_{re} | feedback capacitance | $V_{CE} = 4.8\text{ V}$; $I_C = 0$; $f = 1\text{ MHz}$ | – | 2.5 | pF |



UHF power transistor

BLT70

APPLICATION INFORMATION

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit (see note 1 and Fig.7).

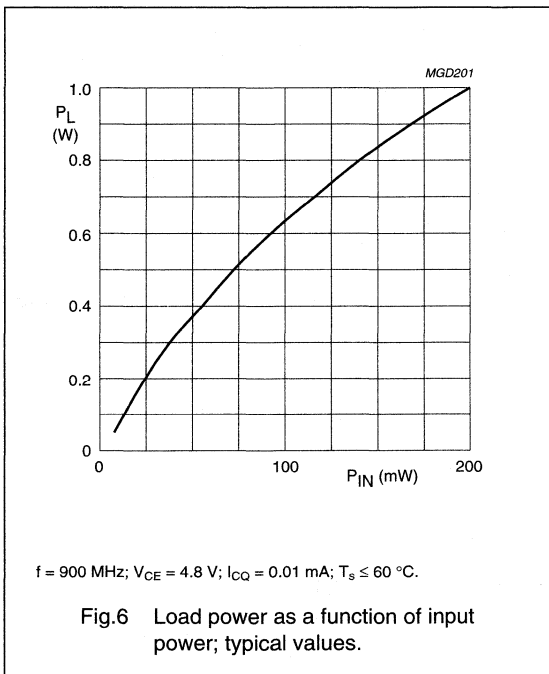
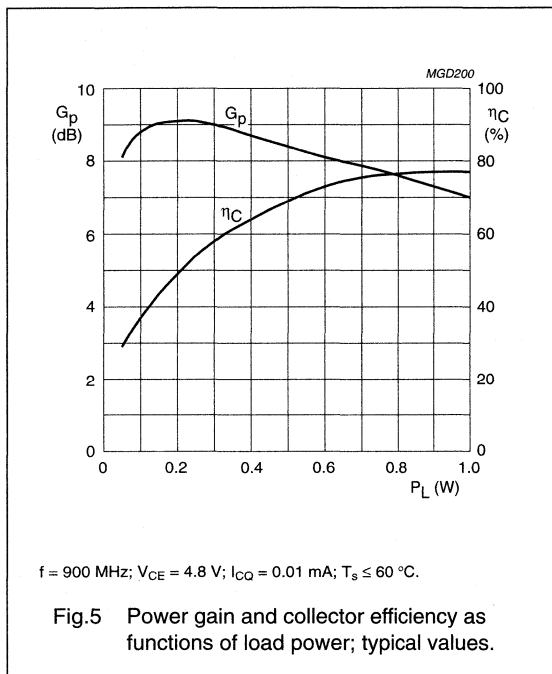
| MODE OF OPERATION | f (MHz) | V_{CE} (V) | I_{CQ} (mA) | P_L (W) | G_p (dB) | η_c (%) |
|-------------------|---------|--------------|---------------|-----------|----------------------|----------------------|
| CW, class-AB | 900 | 4.8 | 0.01 | 0.6 | ≥ 6 typ. 8.1 | ≥ 60 typ. 73 |

Note

- T_s is the temperature at the soldering point of the collector pin.

Ruggedness in class-AB operation

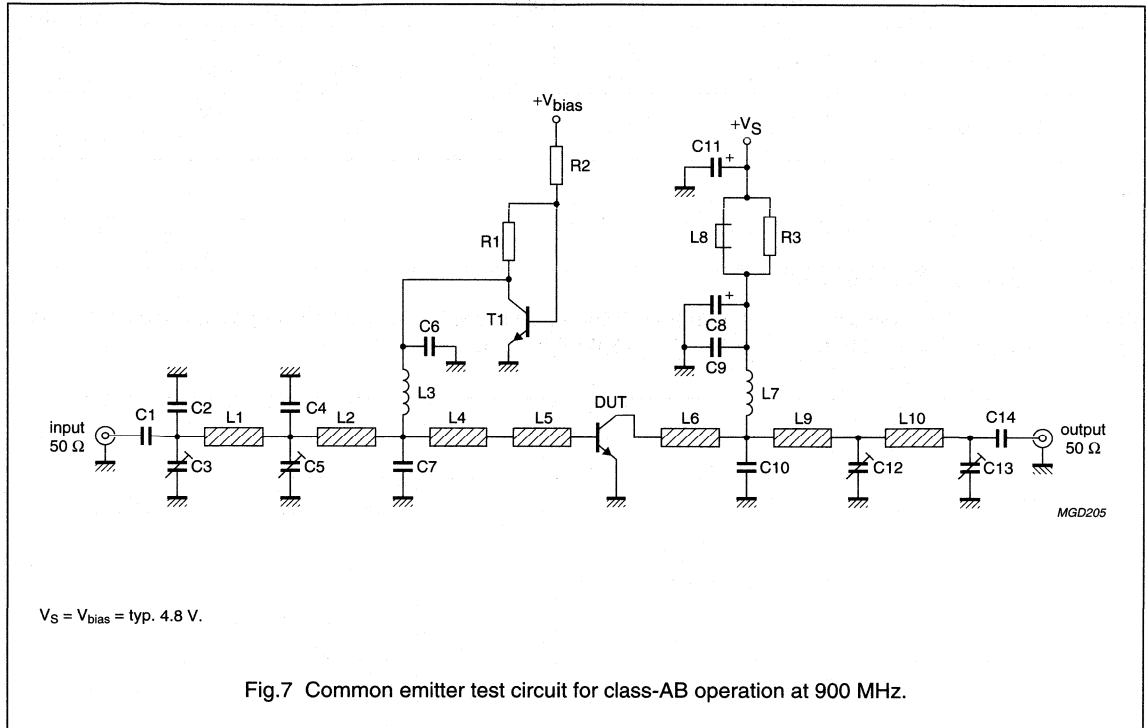
The BLT70 is capable of withstanding a load mismatch corresponding to $VSWR = 6 : 1$ through all phases under the following conditions: $f = 900\text{ MHz}$; $V_{CE} = 6.5\text{ V}$; $P_L = 0.5\text{ W}$; $T_s \leq 60^\circ\text{C}$.



UHF power transistor

BLT70

Test circuit information



UHF power transistor

BLT70

List of components used in test circuit (see Figs 7 and 8)

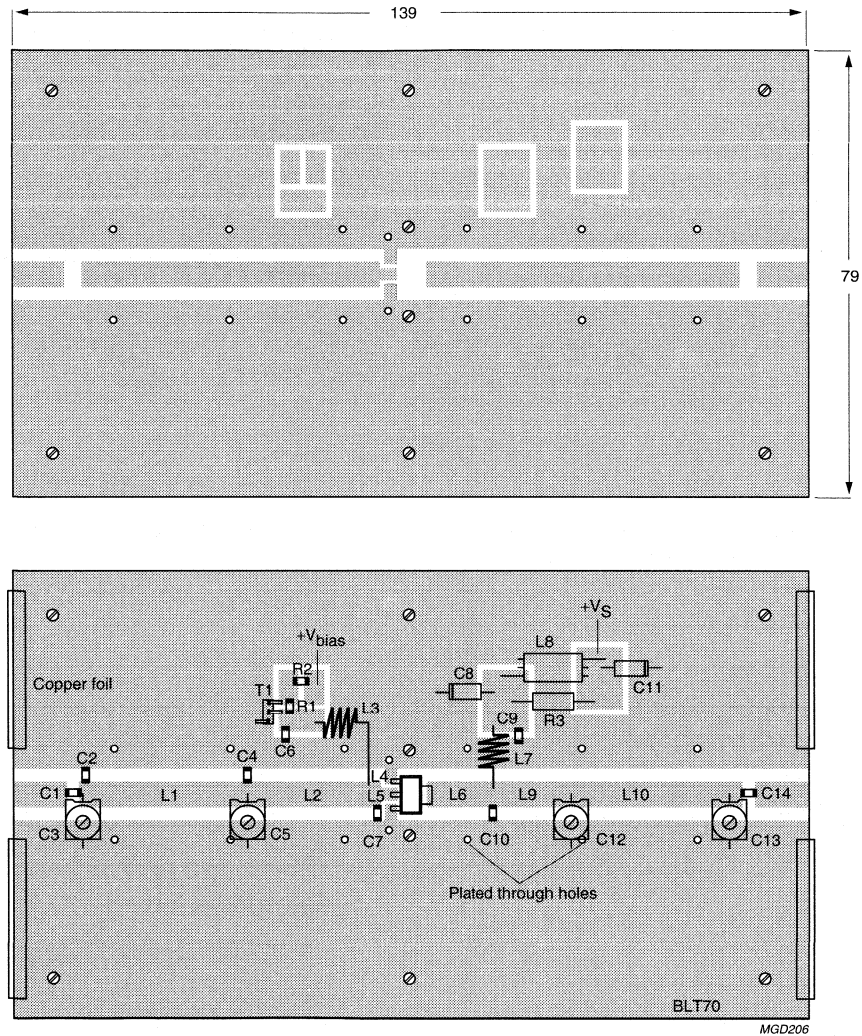
| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE No. |
|------------------|--|---------------------|-------------------------------------|----------------|
| C1, C6, C9, C14 | multilayer ceramic chip capacitor; note 1 | 100 pF | | |
| C2 | multilayer ceramic chip capacitor; note 1 | 1 pF | | |
| C4 | multilayer ceramic chip capacitor; note 1 | 2.4 pF | | |
| C3, C5, C12, C13 | film dielectric trimmer | 1.4 to 5.5 pF | | 2222 809 09004 |
| C7 | multilayer ceramic chip capacitor; note 1 | 5.1 pF | | |
| C8 | tantalum capacitor | 1 μ F, 35 V | | |
| C10 | multilayer ceramic chip capacitor; note 1 | 2.7 pF | | |
| C11 | tantalum capacitor | 100 μ F, 20 V | | |
| L1 | stripline; note 2 | 50 Ω | length 29.1 mm width 5 mm | |
| L2 | stripline; note 2 | 50 Ω | length 21 mm width 5 mm | |
| L3 | 8 turns enamelled 0.8 mm copper wire | 216 nH | length 7 mm internal dia. 4.5 mm | |
| L4 | stripline; note 2 | 50 Ω | length 1 mm width 5 mm | |
| L5 | stripline; note 2 | 50 Ω | length 3 mm width 2.5 mm | |
| L6 | stripline; note 2 | 50 Ω | length 12 mm width 5 mm | |
| L7 | 8 turns enamelled 0.8 mm copper wire | 105 nH | length 7 mm internal dia. 3.4 mm | |
| L8 | grade 3B Ferroxcube wideband HF choke | | | 4132 020 36640 |
| L9 | stripline; note 2 | 50 Ω | length 12 mm width 5 mm | |
| L10 | stripline; note 2 | 50 Ω | length 28 mm width 5 mm | |
| R1 | metal film resistor | 0.1 W, 15 Ω | | |
| R2 | metal film resistor | 0.1 W, 390 Ω | | |
| R3 | metal film resistor | 0.6 W, 10 Ω | | |
| T1 | NPN transistor | BD139 | | |

Notes

- American Technical Ceramics type 100A or capacitor of same quality.
- The striplines are on a double copper-clad printed-circuit board, with DUROID dielectric ($\epsilon_r = 2.2$); thickness $\frac{1}{16}$ "; thickness of the copper sheet $2 \times 35 \mu\text{m}$.

UHF power transistor

BLT70



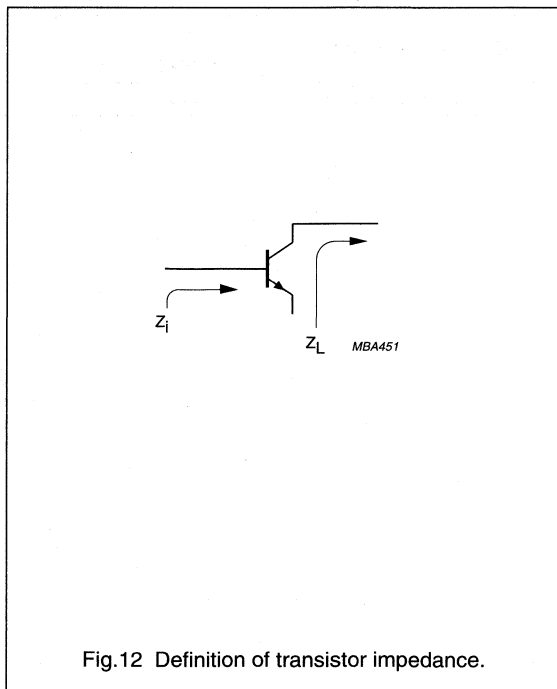
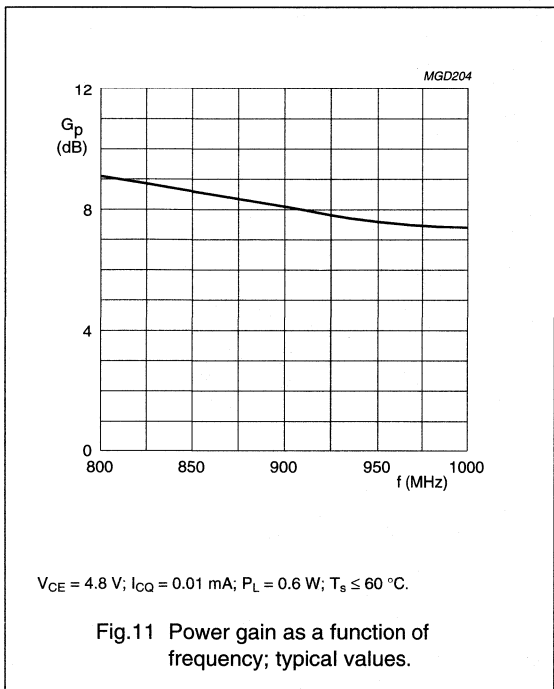
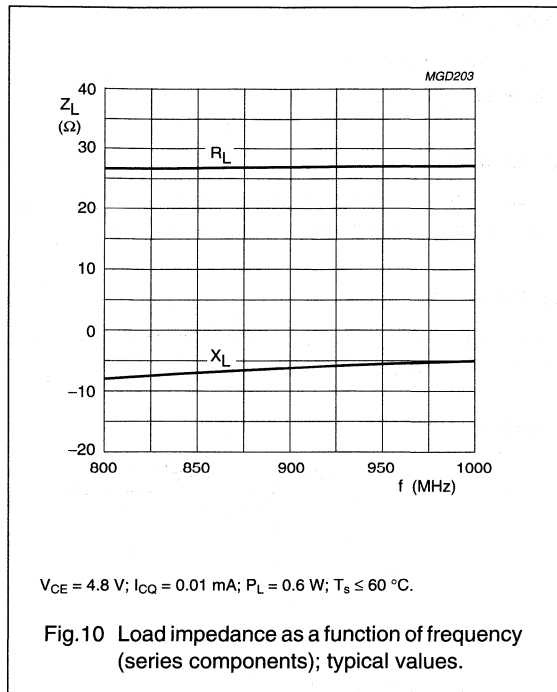
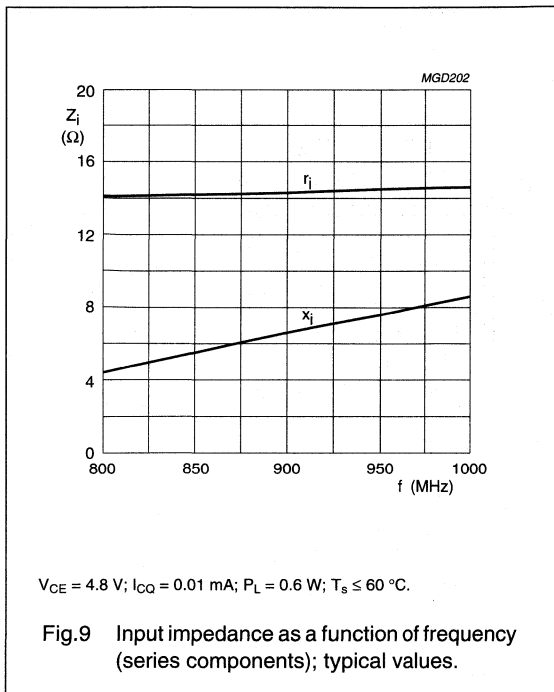
Dimensions in mm.

The components are situated on one side of the copper-clad PCB, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.8 Printed-circuit board and component lay-out for 900 MHz class-AB test circuit in Fig.7.

UHF power transistor

BLT70



UHF power transistor

BLT71

FEATURES

- Very high efficiency
- Low supply voltage.

APPLICATIONS

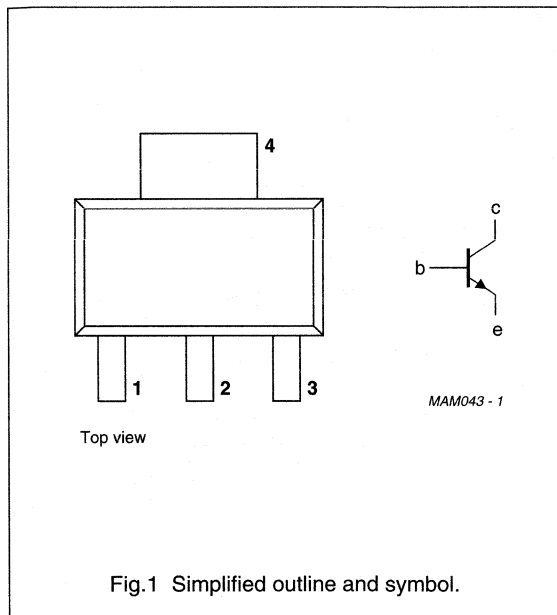
- Hand-held radio equipment in common emitter class-AB operation in the 900 MHz communications band.

DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a SOT223 envelope.

PINNING - SOT223

| PIN | SYMBOL | DESCRIPTION |
|-----|--------|-------------|
| 1 | e | emitter |
| 2 | b | base |
| 3 | e | emitter |
| 4 | c | collector |



QUICK REFERENCE DATA

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit.

| MODE OF OPERATION | f (MHz) | V_{CE} (V) | P_L (W) | G_p (dB) | η_c (%) |
|-------------------|------------|-----------------|--------------|---------------|-----------------|
| CW, class-AB | 900 | 4.8 | 1.2 | ≥ 6 | ≥ 60 |

UHF power transistor

BLT71

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|----------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 16 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 500 | mA |
| P_{tot} | total power dissipation | up to $T_s = 90\text{ °C}$ | – | 3.5 | W |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | operating junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | $P_{tot} = 3.5\text{ W}$; up to $T_s = 90\text{ °C}$; note 1 | 24 | K/W |

Note

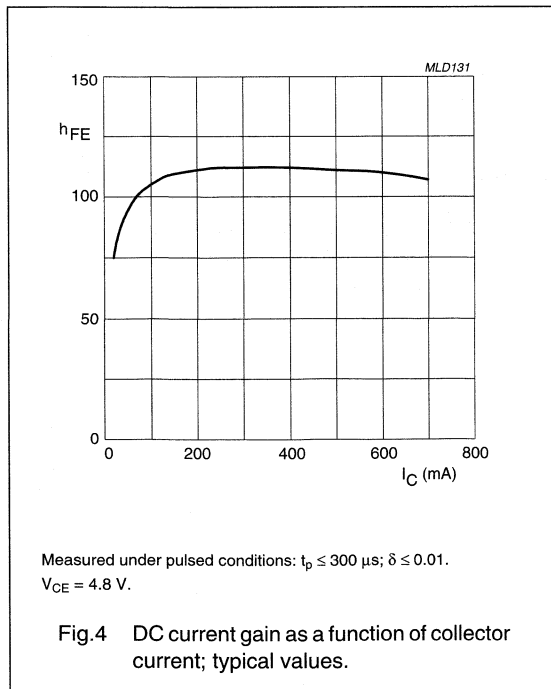
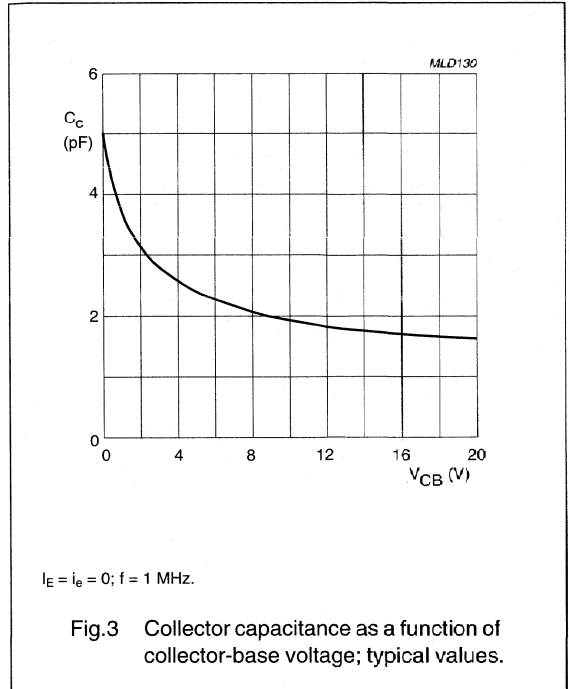
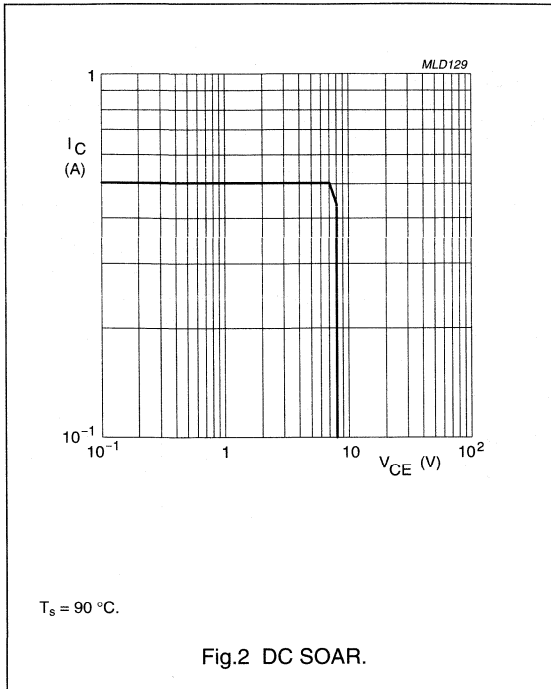
- T_s is the temperature at the soldering point of the collector lead.

CHARACTERISTICS $T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|------|---------------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 0.5\text{ mA}$ | 16 | – | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 10\text{ mA}$ | 8 | – | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.1\text{ mA}$ | 2.5 | – | – | V |
| I_{CES} | collector leakage current | $V_{CE} = 8\text{ V}$; $V_{BE} = 0$ | – | – | 100 | μA |
| h_{FE} | DC current gain | $V_{CE} = 5\text{ V}$; $I_C = 100\text{ mA}$ | 25 | – | – | |
| C_c | collector capacitance | $V_{CB} = 4.8\text{ V}$; $I_E = i_e = 0$; $f = 1\text{ MHz}$ | – | – | 7 | pF |
| C_{re} | feedback capacitance | $V_{CE} = 4.8\text{ V}$; $I_C = 0$; $f = 1\text{ MHz}$ | – | – | 5 | pF |

UHF power transistor

BLT71



UHF power transistor

BLT71

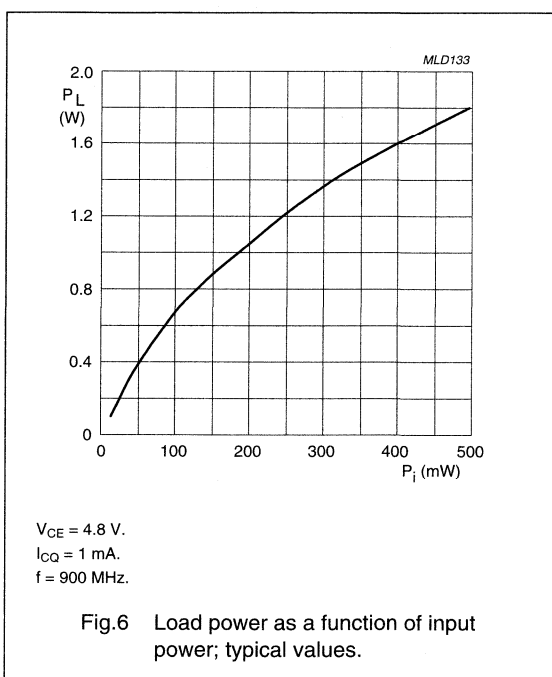
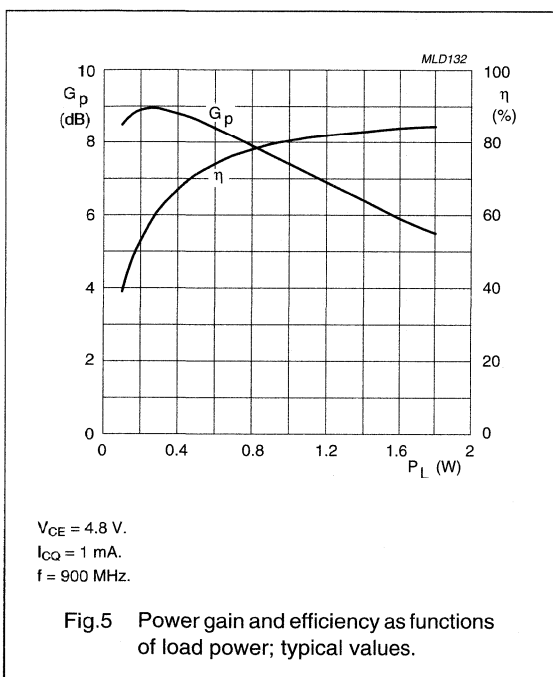
APPLICATION INFORMATION

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit.

| MODE OF OPERATION | f (MHz) | V _{CE} (V) | I _{CQ} (mA) | P _L (W) | G _p (dB) | η_c (%) |
|-------------------|---------|---------------------|----------------------|--------------------|---------------------|--------------|
| CW, class-AB | 900 | 4.8 | 1 | 1.2 | ≥ 6 | ≥ 60 |

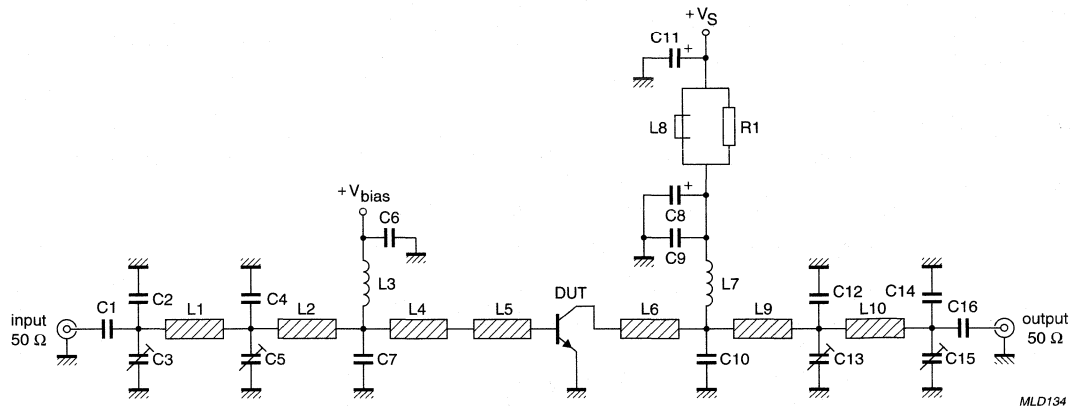
Ruggedness in class-AB operation

The BLT71 is capable of withstanding a load mismatch corresponding to VSWR = 6 : 1 through all phases under the following conditions: P_L = 1.2 W; V_{CE} = 6.5 V; f = 900 MHz.



UHF power transistor

BLT71



MLD134

Fig.7 Class-AB test circuit at 900 MHz.

UHF power transistor

BLT71

List of components (see Figs 7 and 8)

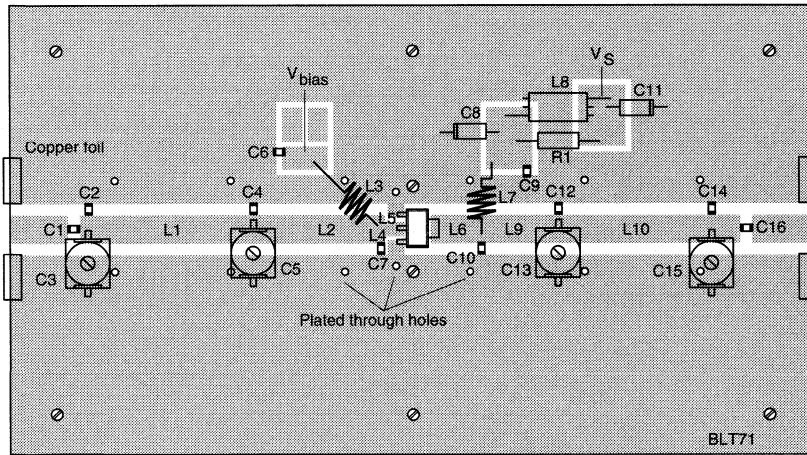
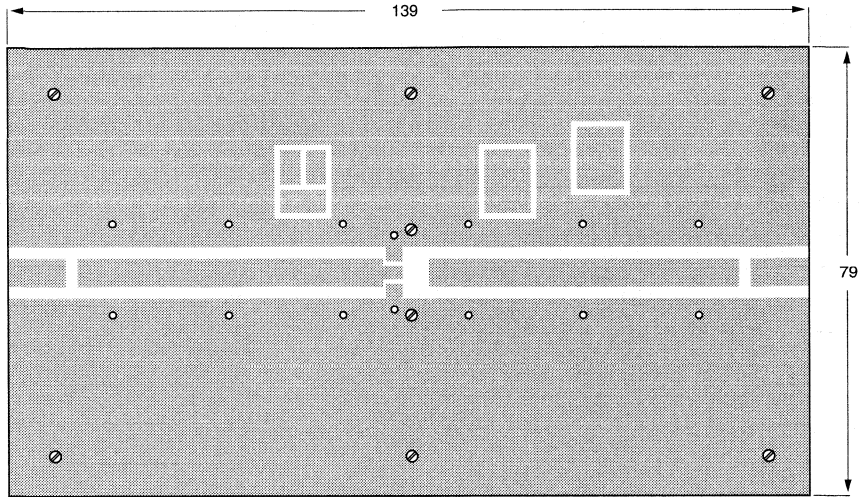
| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE No. |
|------------------|--|--------------------|---------------------------------------|----------------|
| C1, C6, C9, C16 | multilayer ceramic chip capacitor; note 1 | 100 pF | | |
| C2, C4, C12, C14 | multilayer ceramic chip capacitor; note 1 | 1 pF | | |
| C3, C5, C13, C15 | film dielectric trimmer | 1.4 to 5.5 pF | | 2222 809 09004 |
| C7 | multilayer ceramic chip capacitor; note 1 | 6.8 pF | | |
| C8 | tantalum capacitor | 1 μ F, 35 V | | |
| C10 | multilayer ceramic chip capacitor; note 1 | 5.1 pF | | |
| C11 | tantalum capacitor | 100 μ F, 20 V | | |
| L1 | stripline; note 2 | 50 Ω | length 28.5 mm width 5 mm | |
| L2 | stripline; note 2 | 50 Ω | length 23 mm width 5 mm | |
| L3 | 11 turns enamelled 0.6 mm copper wire | 100 nH | length 7.5 mm internal dia. 3.3 mm | |
| L4 | stripline; note 2 | 50 Ω | length 1 mm width 5 mm | |
| L5 | stripline; note 2 | 50 Ω | length 3 mm width 2.5 mm | |
| L6 | stripline; note 2 | 50 Ω | length 9 mm width 5 mm | |
| L7 | 7 turns enamelled 0.6 mm copper wire | 37 nH | length 7.3 mm internal dia. 3.3 mm | |
| L8 | grade 3B Ferroxcube wideband HF choke | | | 4132 020 36640 |
| L9 | stripline; note 2 | 50 Ω | length 13.5 mm width 5 mm | |
| L10 | stripline; note 2 | 50 Ω | length 26.5 mm width 5 mm | |
| R1 | metal film resistor | 0.1 W, 10 Ω | | |

Notes

- American Technical Ceramics type 100A or capacitor of same quality.
- The striplines are on a double copper-clad printed-circuit board, with DUROID dielectric ($\epsilon_r = 2.2$); thickness $\frac{1}{16}$ "; thickness of the copper sheet $2 \times 35 \mu\text{m}$.

UHF power transistor

BLT71



MLD135

Dimensions in mm.

The components are situated on one side of the copper-clad PCB, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.8 Component lay-out and printed-circuit board for 900 MHz class-AB test circuit.

UHF power transistor

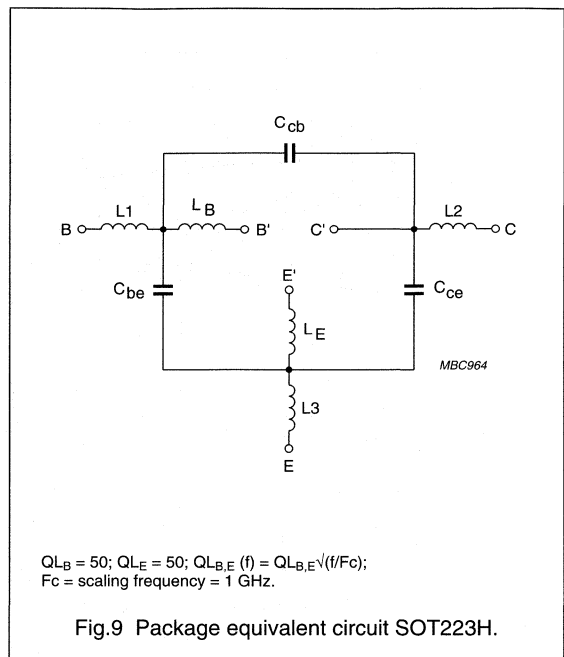
BLT71

SPICE parameters for the BLT71 crystal

| SEQUENCE No. | PARAMETER | VALUE | UNIT |
|-------------------|-----------|-------|------------|
| 1 | IS | 3.503 | fA |
| 2 | BF | 190.5 | — |
| 3 | NF | 0.981 | — |
| 4 | VAF | 35.45 | V |
| 5 | IKF | 24.52 | A |
| 6 | ISE | 184.9 | fA |
| 7 | NE | 1.475 | — |
| 8 | BR | 12.61 | — |
| 9 | NR | 1.042 | — |
| 10 | VAR | 1.476 | V |
| 11 | IKR | 2.206 | A |
| 12 | ISC | 866.5 | aA |
| 13 | NC | 1.025 | — |
| 14 | RB | 2.000 | Ω |
| 15 | IRB | 1.000 | μ A |
| 16 | RBM | 2.000 | Ω |
| 17 | RE | 373.8 | m Ω |
| 18 | RC | 330.6 | m Ω |
| 19 ⁽¹⁾ | XTB | 0.000 | — |
| 20 ⁽¹⁾ | EG | 1.110 | eV |
| 21 ⁽¹⁾ | XTI | 3.000 | — |
| 22 | CJE | 9.746 | pF |
| 23 | VJE | 0.600 | V |
| 24 | MJE | 0.288 | — |
| 25 | TF | 11.99 | ps |
| 26 | XTF | 0.979 | — |
| 27 | VTF | 19.52 | mV |
| 28 | ITF | 0.137 | A |
| 29 | PTF | 0.000 | deg |
| 30 | CJC | 5.028 | pF |
| 31 | VJC | 0.609 | V |
| 32 | MJC | 0.368 | — |
| 33 | XCJC | 0.150 | — |
| 34 | TR | 3.841 | ns |
| 35 ⁽¹⁾ | CJS | 0.000 | F |
| 36 ⁽¹⁾ | VJS | 750.0 | mV |
| 37 ⁽¹⁾ | MJS | 0.000 | — |
| 38 | FC | 0.813 | — |

Note

- These parameters have not been extracted, the default values are shown.

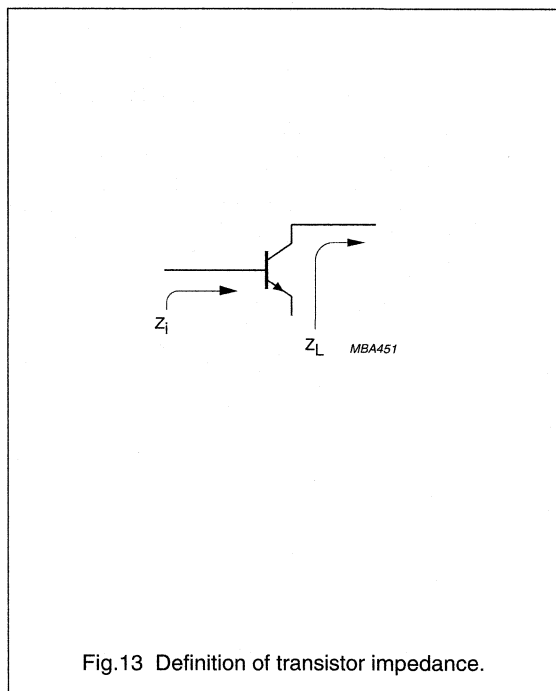
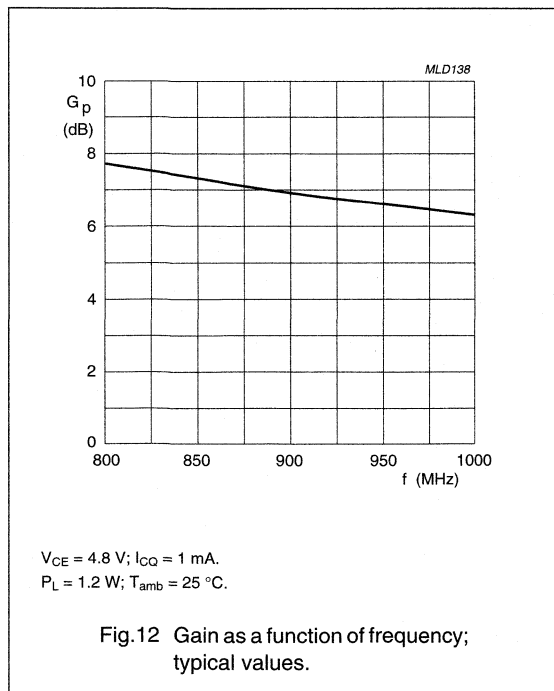
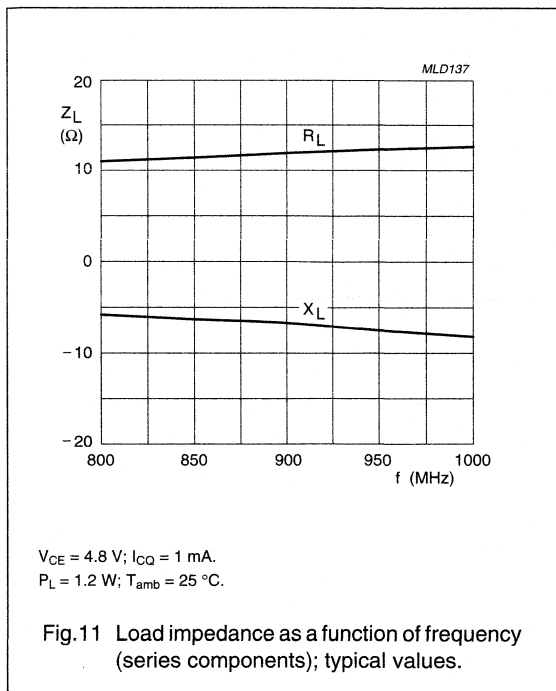
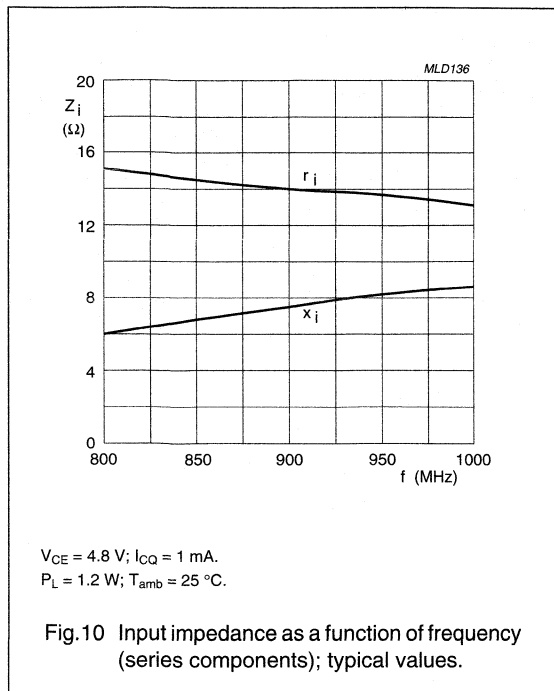


List of components (see Fig.9)

| DESIGNATION | VALUE | UNIT |
|-------------|-------|------|
| C_{be} | 182 | fF |
| C_{cb} | 16 | fF |
| C_{ce} | 249 | fF |
| L1 | 0.025 | nH |
| L2 | 1.19 | nH |
| L3 | 0.6 | nH |
| L_B | 1.85 | nH |
| L_E | 1.22 | nH |

UHF power transistor

BLT71



UHF power transistor

BLT71/8

FEATURES

- High efficiency
- Very high gain
- Internal pre-matched input
- Low supply voltage.

APPLICATIONS

- Hand-held radio equipment in common emitter class-AB operation for the 900 MHz communication band.

DESCRIPTION

NPN silicon planar epitaxial power transistor encapsulated in a SOT96-1 (SO8) plastic SMD package.

PINNING - SOT96-1

| PIN | SYMBOL | DESCRIPTION |
|------------|--------|-------------|
| 1, 8 | b | base |
| 2, 4, 5, 7 | e | emitter |
| 3, 6 | c | collector |

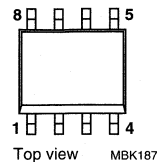


Fig.1 Simplified outline.

QUICK REFERENCE DATA

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit.

| MODE OF OPERATION | f (MHz) | V_{CE} (V) | P_L (W) | G_p (dB) | η_c (%) |
|-------------------|---------|--------------|-----------|----------------------|----------------------|
| CW, class-AB | 900 | 4.8 | 1.2 | ≥ 11 typ. 13 | ≥ 55 typ. 63 |

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|--|------|------|------------------|
| V_{CBO} | collector-base voltage | open emitter | – | 16 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 8 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 500 | mA |
| P_{tot} | total power dissipation | $T_s = 60^\circ\text{C}$; $V_{CE} \leq 6.5\text{ V}$; note 1 | – | 2.9 | W |
| T_{stg} | storage temperature | | –65 | +150 | $^\circ\text{C}$ |
| T_j | operating junction temperature | | – | 175 | $^\circ\text{C}$ |

Note

1. T_s is the temperature at the soldering point of the collector pin.

UHF power transistor

BLT71/8

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | MAX. | UNIT |
|---------------|---|--|------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | $P_{dis} = 2.9\text{ W}$; $T_s = 60\text{ °C}$; note 1 | 40 | K/W |

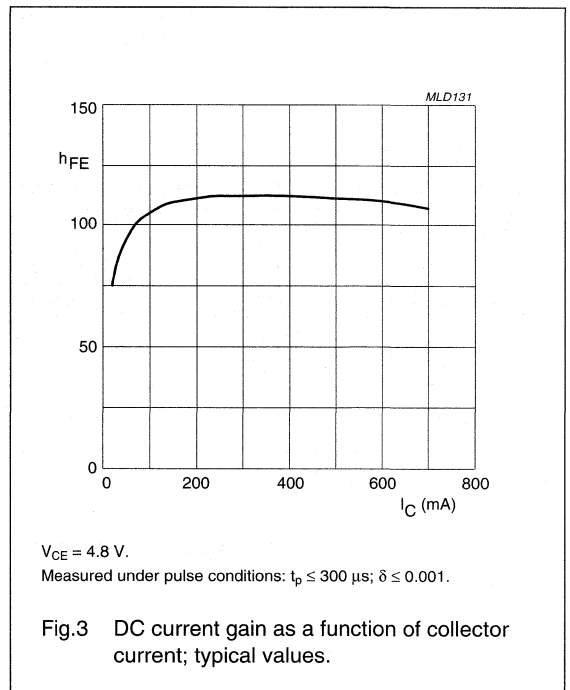
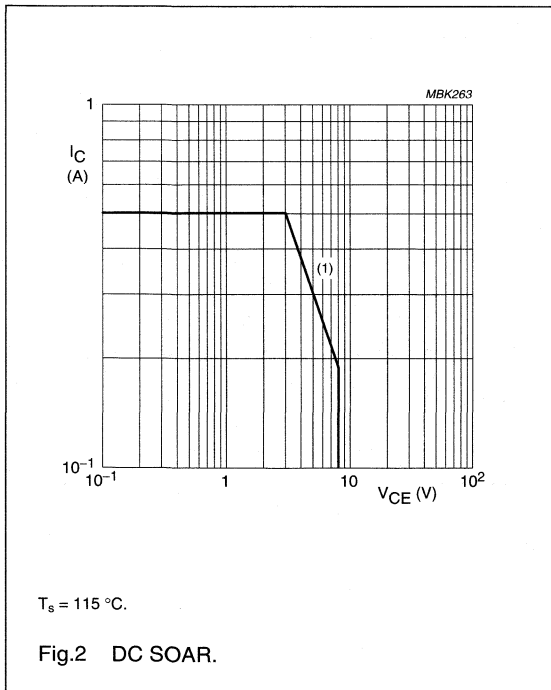
Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\text{ °C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 0.5\text{ mA}$ | 16 | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 10\text{ mA}$ | 8 | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.1\text{ mA}$ | 2.5 | – | V |
| I_{CES} | collector leakage current | $V_{CE} = 8\text{ V}$; $V_{BE} = 0$ | – | 0.1 | mA |
| h_{FE} | DC current gain | $V_{CE} = 5\text{ V}$; $I_C = 100\text{ mA}$ | 25 | – | |
| C_c | collector capacitance | $V_{CB} = 4.8\text{ V}$; $I_E = I_B = 0$; $f = 1\text{ MHz}$ | – | 7 | pF |
| C_{re} | feedback capacitance | $V_{CE} = 4.8\text{ V}$; $I_C = 0$; $f = 1\text{ MHz}$ | – | 5 | pF |



UHF power transistor

BLT71/8

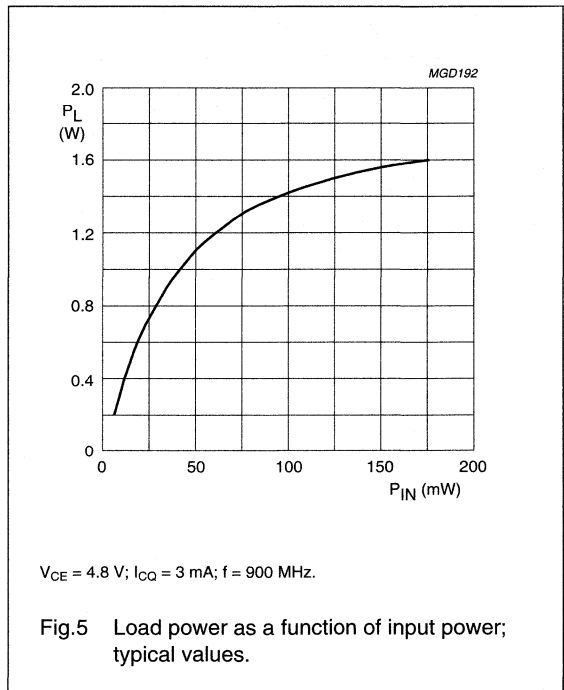
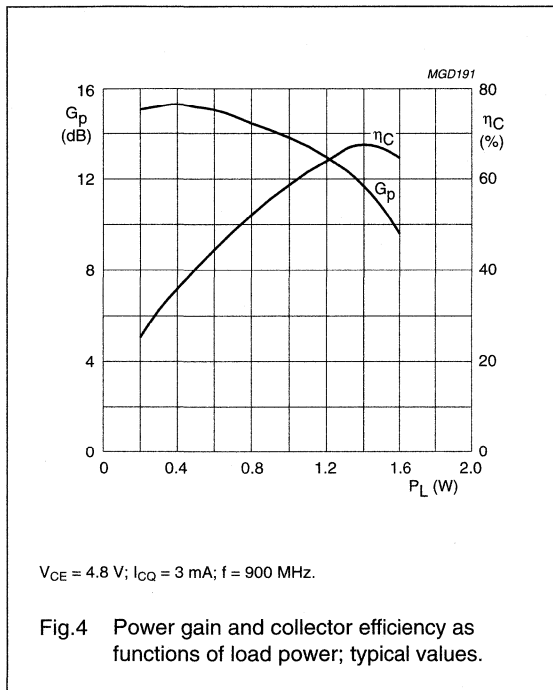
APPLICATION INFORMATION

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit.

| MODE OF OPERATION | f (MHz) | V_{CE} (V) | I_{CQ} (mA) | P_L (W) | G_p (dB) | η_c (%) |
|-------------------|---------|--------------|---------------|-----------|----------------------|----------------------|
| CW, class-AB | 900 | 4.8 | 3 | 1.2 | ≥ 11 typ. 13 | ≥ 55 typ. 63 |

Ruggedness in class-AB operation

The BLT71/8 is capable of withstanding a load mismatch corresponding to $V_{SWR} = 6 : 1$ through all phases under the following conditions: $f = 900\text{ MHz}$; $V_{CE} = 6.5\text{ V}$; $I_{CQ} = 3\text{ mA}$; $P_L = 1.2\text{ W}$; $T_s = 60^\circ\text{C}$.



UHF power transistor

BLT71/8

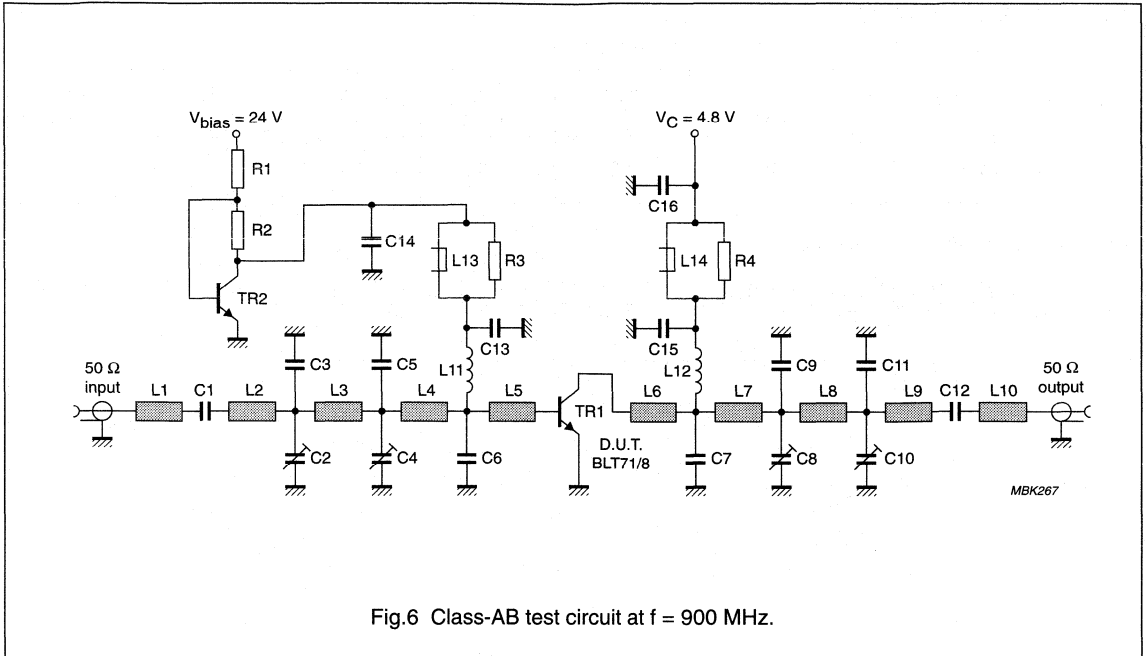
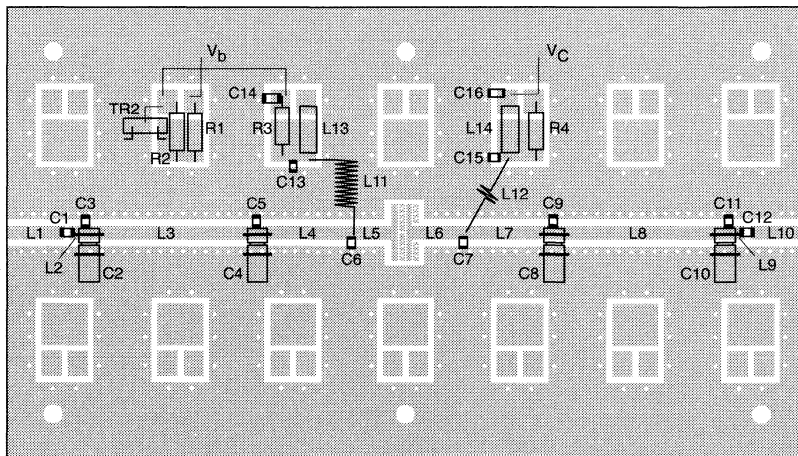
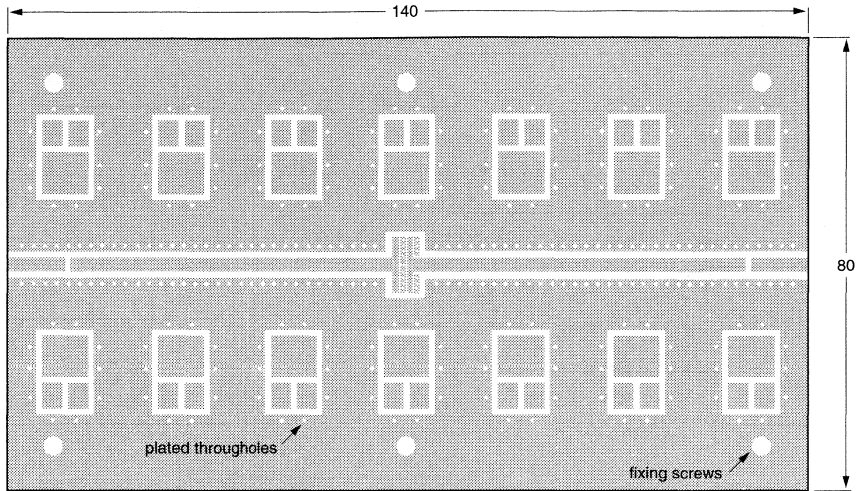


Fig.6 Class-AB test circuit at f = 900 MHz.

UHF power transistor

BLT71/8



MBK266

Dimensions in mm

The components are situated on one side of the copper-clad printed circuit board, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by through metallization.

Fig.7 Printed-circuit board and component lay-out for the 900 MHz class-AB test circuit.

UHF power transistor

BLT71/8

List of components (see Figs 6 and 7).

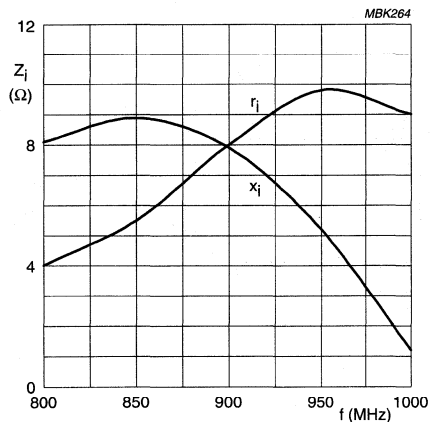
| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE NO. |
|-------------------|---|------------------------|---|----------------|
| C1, C12, C13, C15 | multilayer ceramic chip capacitor; note 1 | 120 pF | | |
| C2, C4, C8, C10 | Giga-Trim capacitor; note 2 | 0.6 to 4.5 pF | | |
| C3 | multilayer ceramic chip capacitor; note 1 | 4.7 pF | | |
| C5 | multilayer ceramic chip capacitor; note 1 | 5.6 pF | | |
| C6 | multilayer ceramic chip capacitor; note 1 | 3.9 pF | | |
| C7 | multilayer ceramic chip capacitor; note 1 | 6.8 pF | | |
| C9 | multilayer ceramic chip capacitor; note 1 | 7.5 pF | | |
| C11 | multilayer ceramic chip capacitor; note 1 | 5.1 pF | | |
| C14, C16 | multilayer ceramic chip capacitor; note 1 | 10 nF | | |
| L1, L10 | stripline; note 3 | 50 Ω | 10 x 2.4 mm | |
| L2 | stripline; note 3 | 50 Ω | 2 x 2.4 mm | |
| L3 | stripline; note 3 | 50 Ω | 30.4 x 2.4 mm | |
| L4 | stripline; note 3 | 50 Ω | 17.4 x 2.4 mm | |
| L5 | stripline; note 3 | 50 Ω | 6.8 x 2.4 mm | |
| L6 | stripline; note 3 | 50 Ω | 8 x 2.4 mm | |
| L7 | stripline; note 3 | 50 Ω | 19 x 2.4 mm | |
| L8 | stripline; note 3 | 50 Ω | 28 x 2.4 mm | |
| L9 | stripline; note 3 | 50 Ω | 1.6 x 2.4 mm | |
| L11 | 10 turns 1 mm enamelled copper wire | 140 nH | int. dia. = 4 mm; lead 1 = 2.5 mm; lead 2 = 11 mm | |
| L12 | 2 turns 1 mm enamelled copper wire | 60 nH | int. dia. = 2 mm; leads = 2 x 7.5 mm | |
| L13, L14 | 4S2 wideband RF choke | | | 4330 030 36301 |
| R1 | metal film resistor | 1.4 k Ω ; 0.6 W | | 2322 156 11402 |
| R2, R3, R4 | metal film resistor | 10 Ω ; 0.6 W | | 2322 156 11009 |
| TR1 | device under test | BLT71/8 | | |
| TR2 | NPN transistor | BD139 | | 9330 912 20112 |

Notes

- American Technical Ceramics type 100A or capacitor of same quality.
- Tekelec Giga-trim, type 37271.
- The striplines are on a double copper-clad printed-circuit board, with DUROID dielectric ($\epsilon_r = 2.2$); thickness 0.79 mm, thickness of the copper sheet 2 x 35 μm .

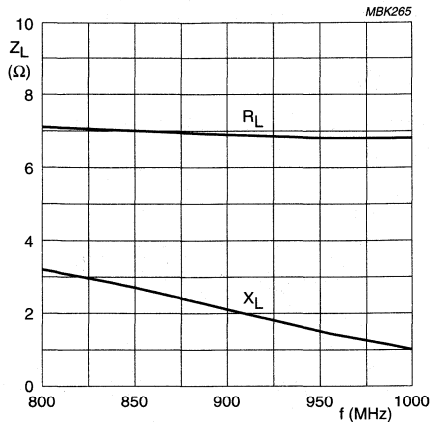
UHF power transistor

BLT71/8



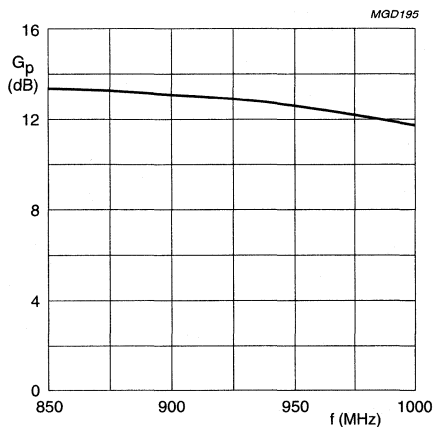
$V_{CE} = 4.8 \text{ V}; I_{CQ} = 3 \text{ mA}; P_L = 1.2 \text{ W}; T_{amb} = 25 \text{ }^\circ\text{C}.$

Fig.8 Input impedance as a function of frequency (series components); typical values.



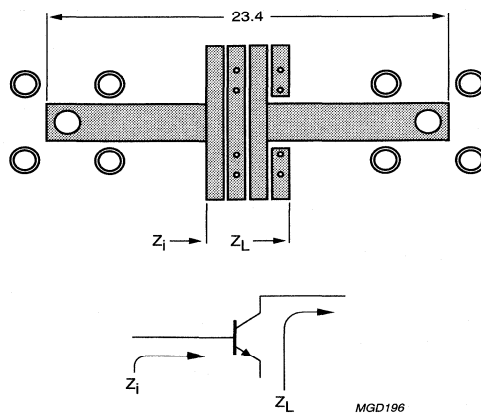
$V_{CE} = 4.8 \text{ V}; I_{CQ} = 3 \text{ mA}; P_L = 1.2 \text{ W}; T_{amb} = 25 \text{ }^\circ\text{C}.$

Fig.9 Load impedance as a function of frequency (series components); typical values.



$V_{CE} = 4.8 \text{ V}; I_{CQ} = 3 \text{ mA}; P_L = 1.2 \text{ W}; T_{amb} = 25 \text{ }^\circ\text{C}.$

Fig.10 Power gain as a function of frequency (series components); typical values.



Dimensions in mm.

Fig.11 RF test print and definition of transistor impedance.

UHF power transistor

BLT80

FEATURES

- SMD encapsulation
- Gold metallization ensures excellent reliability.

APPLICATIONS

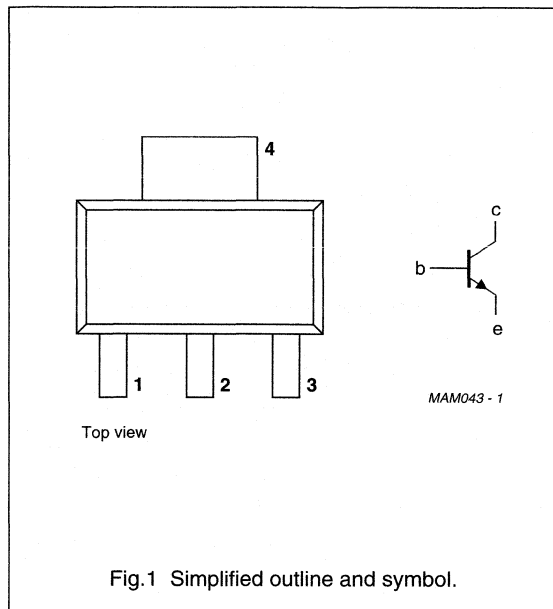
- Hand-held radio equipment in the 900 MHz communication band.

DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a plastic SOT223 SMD package.

PINNING - SOT223

| PIN | SYMBOL | DESCRIPTION |
|-----|--------|-------------|
| 1 | e | emitter |
| 2 | b | base |
| 3 | e | emitter |
| 4 | c | collector |



QUICK REFERENCE DATA

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit (see Fig.7).

| MODE OF OPERATION | f (MHz) | V_{CE} (V) | P_L (W) | G_p (dB) | η_c (%) |
|-------------------------|------------|-----------------|--------------|---------------|-----------------|
| CW, class-B narrow band | 900 | 7.5 | 0.8 | ≥ 6 | ≥ 60 |

UHF power transistor

BLT80

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

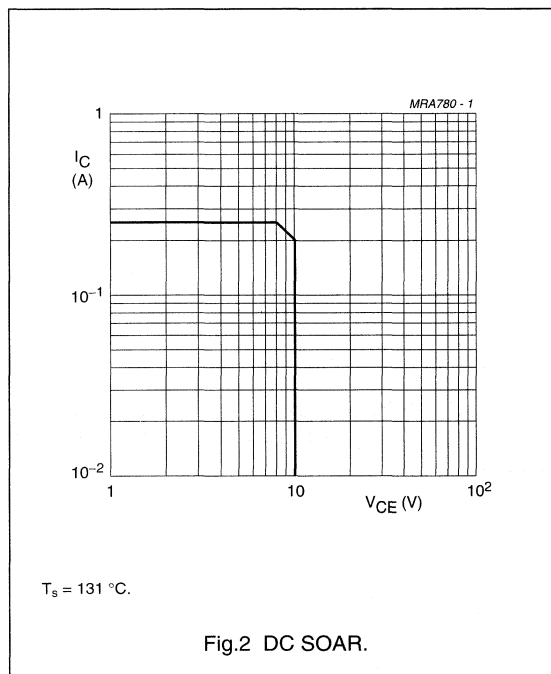
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-------------|--------------------------------|------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| I_C | collector current (DC) | | – | 250 | mA |
| $I_{C(AV)}$ | average collector current | | – | 250 | mA |
| I_{CM} | peak collector current | $f > 1$ MHz | – | 750 | mA |
| P_{tot} | total power dissipation | $T_s = 131$ °C; note 1 | – | 2 | W |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | operating junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|--|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | $P_{tot} = 2$ W; $T_s = 131$ °C; note 1 | 22 | K/W |
| $R_{th\ j-a}$ | thermal resistance from junction to ambient | $P_{tot} = 2$ W; $T_{amb} = 25$ °C; note 2 | 85 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.
- Transistor mounted on a printed-circuit board measuring $40 \times 40 \times 1$ mm, collector pad 35×17 mm.



UHF power transistor

BLT80

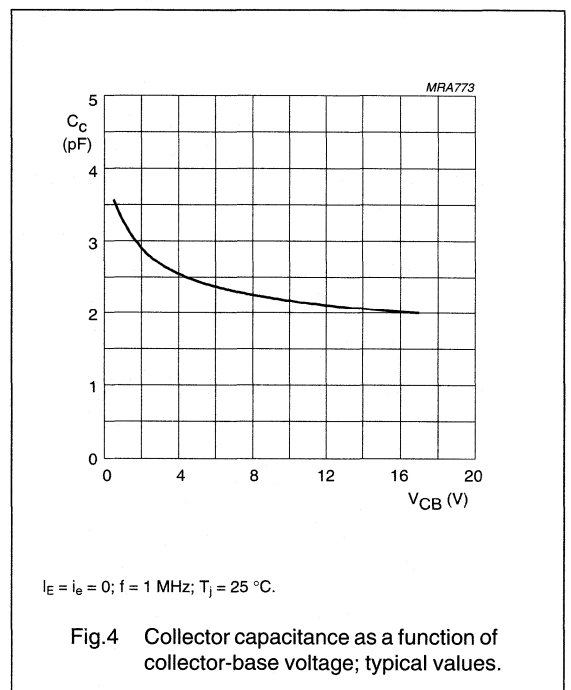
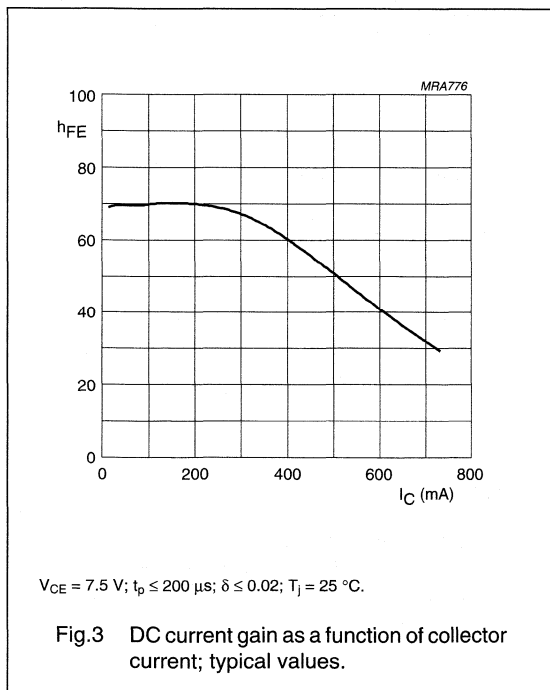
CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 2.5\text{ mA}$ | 20 | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 5\text{ mA}$ | 10 | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.5\text{ mA}$ | 3 | – | V |
| I_{CES} | collector leakage current | $V_{CE} = 10\text{ V}$; $V_{BE} = 0$ | – | 0.1 | mA |
| h_{FE} | DC current gain | $V_{CE} = 5\text{ V}$; $I_C = 150\text{ mA}$; note 1; see Fig.3 | 25 | – | |
| C_c | collector capacitance | $V_{CB} = 7.5\text{ V}$; $I_E = i_e = 0$; $f = 1\text{ MHz}$; see Fig.4 | – | 3.5 | pF |
| C_{re} | feedback capacitance | $V_{CE} = 7.5\text{ V}$; $I_C = 0$; $f = 1\text{ MHz}$ | – | 2.5 | pF |

Note

1. Measured under pulsed conditions: $t_p \leq 200\text{ }\mu\text{s}$; $\delta \leq 0.02$.



UHF power transistor

BLT80

APPLICATION INFORMATION

RF performance at $T_s \leq 60\text{ }^\circ\text{C}$ in a common emitter test circuit (see note 1 and Fig.7).

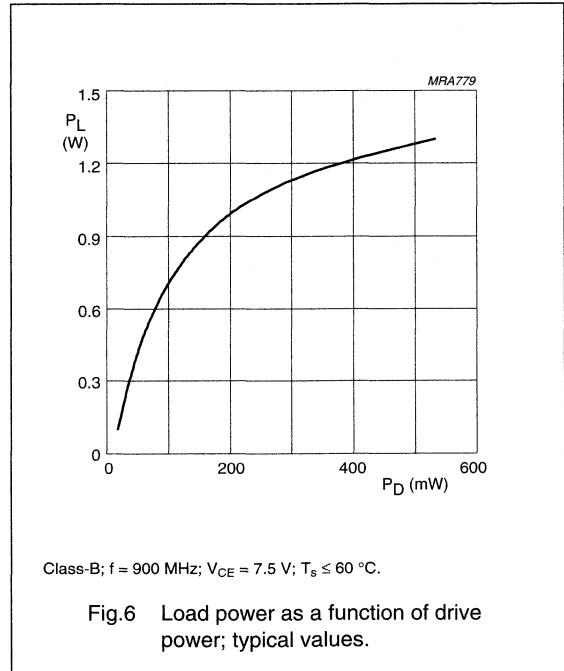
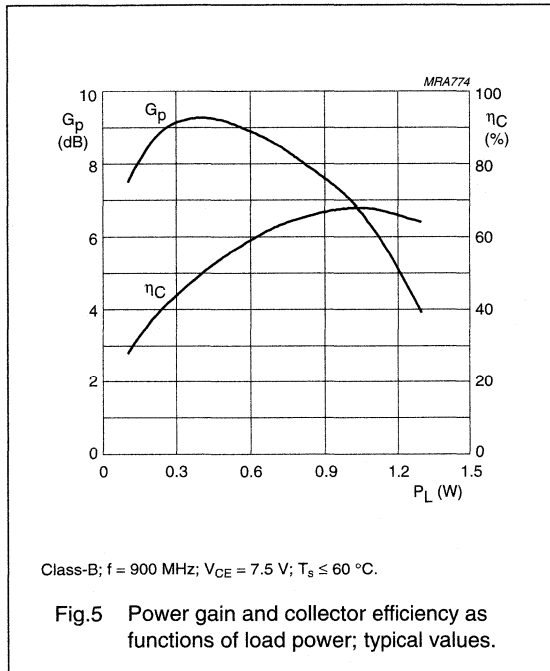
| MODE OF OPERATION | f (MHz) | V _{CE} (V) | P _L (W) | G _p (dB) | η_c (%) |
|-------------------------|---------|---------------------|--------------------|---------------------|----------------------|
| CW, class-B narrow band | 900 | 7.5 | 0.8 | ≥ 6 typ. 8 | ≥ 60 typ. 67 |

Note

1. T_s is the temperature at the soldering point of the collector pin.

Ruggedness in class-AB operation

The BLT80 is capable of withstanding a load mismatch corresponding to $V_{SWR} = 50 : 1$ through all phases under the following conditions: $f = 900\text{ MHz}$; $V_{CE} = 9\text{ V}$; $P_L = 0.8\text{ W}$; $T_s \leq 60\text{ }^\circ\text{C}$.



UHF power transistor

BLT80

Test circuit information

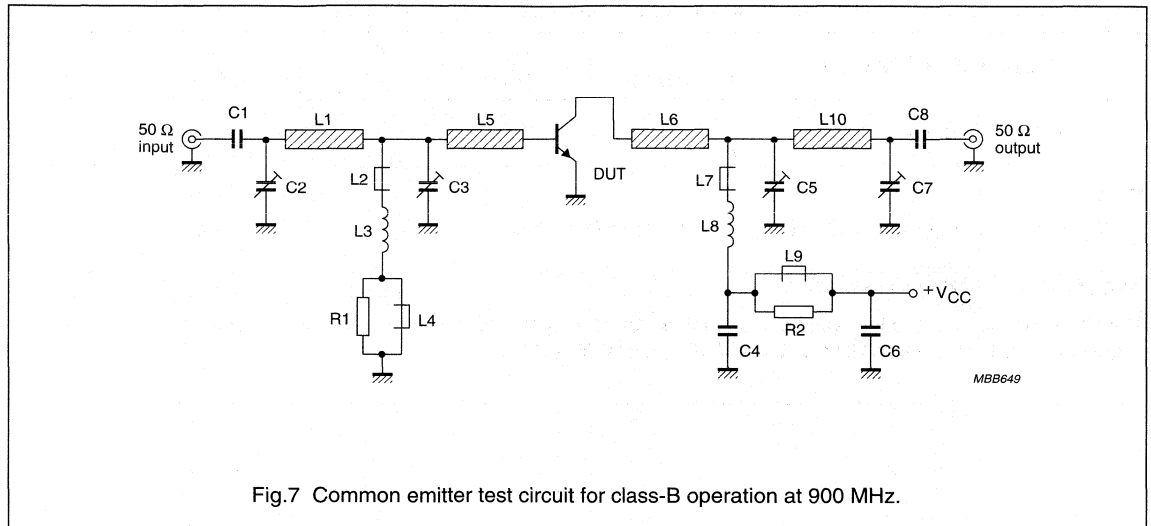


Fig.7 Common emitter test circuit for class-B operation at 900 MHz.

List of components used in test circuit (see Figs 7 and 8)

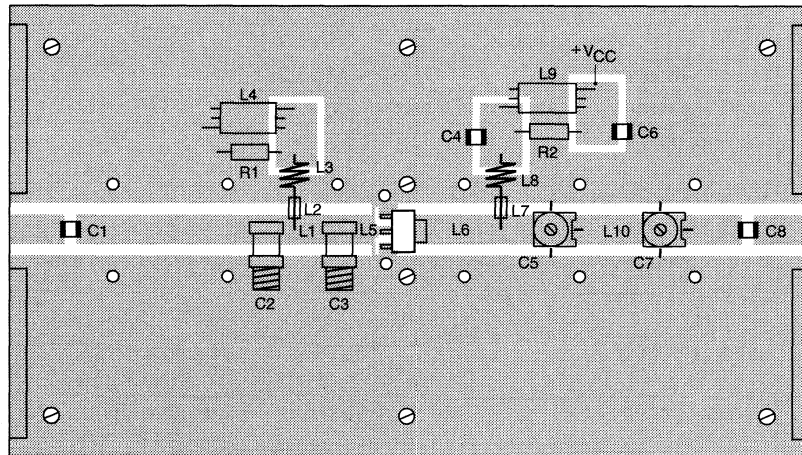
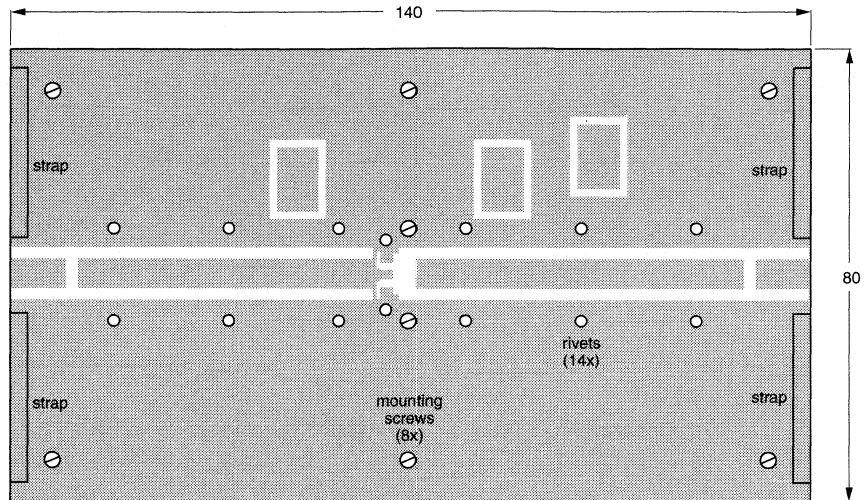
| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE No. |
|-----------|---|---------------|--------------------------------|----------------|
| C1, C8 | multilayer ceramic chip capacitor; note 1 | 100 pF | | |
| C2, C3 | type 9105 Voltronix KM10 trimmer | 0.6 to 10 pF | | |
| C4 | multilayer ceramic chip capacitor; note 1 | 220 pF | | |
| C5, C7 | film dielectric trimmer | 1.4 to 5.5 pF | | 2222 809 09001 |
| C6 | multilayer ceramic chip capacitor; note 1 | 1 nF | | |
| L1 | stripline; note 2 | 50 Ω | length 13 mm width 4.85 mm | |
| L2, L7 | 1 turn 0.4 mm copper wire on grade 3B core | | | 4330 030 32221 |
| L3, L8 | 6 turns enamelled 0.8 mm copper wire | | internal dia. 3 mm | |
| L4, L9 | grade 3B Ferroxcube wideband HF choke | | | 4312 020 36640 |
| L5 | stripline; note 2 | 50 Ω | length 8.4 mm width 4.85 mm | |
| L6 | stripline; note 2 | 50 Ω | length 20 mm width 4.85 mm | |
| L10 | stripline; note 2 | 50 Ω | length 21 mm width 4.85 mm | |
| R1, R2 | metal film resistor | 10 Ω, 0.25 W | | |

Notes

- American Technical Ceramics type 100A or capacitor of same quality.
- The striplines are on a double copper-clad printed-circuit board, with PTFE fibre-glass dielectric ($\epsilon_r = 2.2$); thickness $\frac{1}{16}$ " ; thickness of the copper sheet 35 μm .

UHF power transistor

BLT80



MBB648

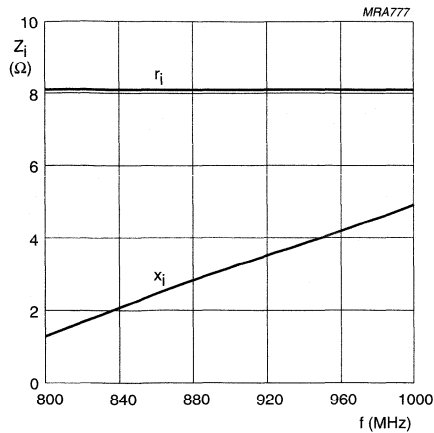
Dimensions in mm.

The components are situated on one side of the copper-clad PTFE fibre-glass board, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by means of fixing screws and copper foil straps under the emitter leads.

Fig.8 Printed-circuit board and component lay-out for 900 MHz class-B test circuit in Fig.7.

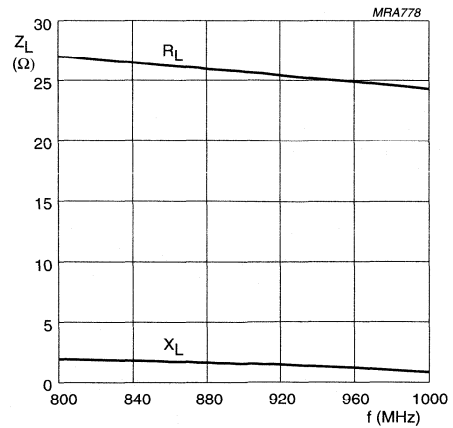
UHF power transistor

BLT80



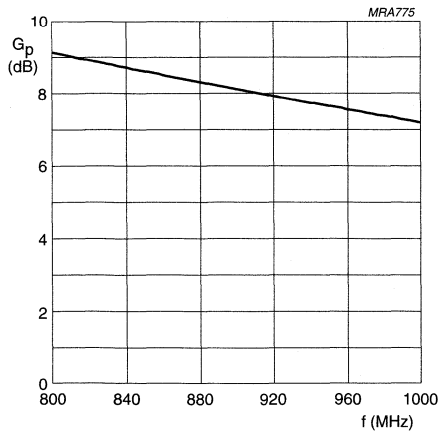
Class-B; $V_{CE} = 7.5 \text{ V}$; $P_L = 0.8 \text{ W}$; $T_s \leq 60 \text{ }^\circ\text{C}$.

Fig.9 Input impedance as a function of frequency (series components); typical values.



Class-B; $V_{CE} = 7.5 \text{ V}$; $P_L = 0.8 \text{ W}$; $T_s \leq 60 \text{ }^\circ\text{C}$.

Fig.10 Load impedance as a function of frequency (series components); typical values.



Class-B; $V_{CE} = 7.5 \text{ V}$; $P_L = 0.8 \text{ W}$; $T_s \leq 60 \text{ }^\circ\text{C}$.

Fig.11 Power gain as a function of frequency; typical values.

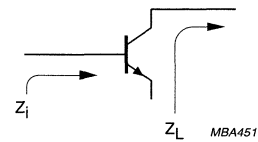


Fig.12 Definition of transistor impedance.

UHF power transistor

BLT81

FEATURES

- SMD encapsulation
- Gold metallization ensures excellent reliability.

APPLICATIONS

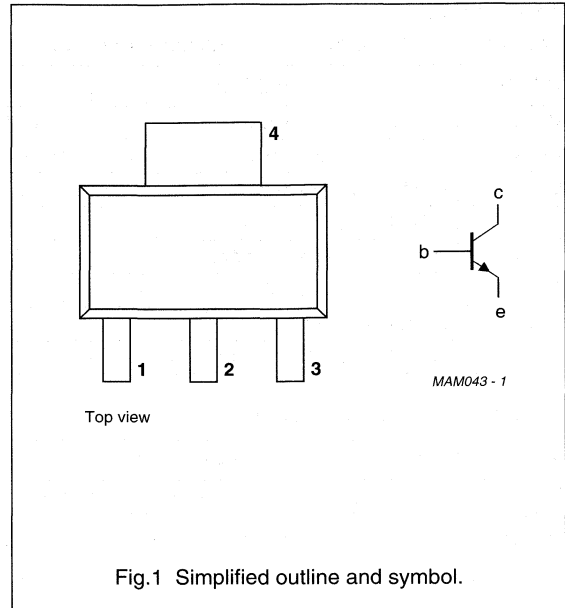
- Hand-held radio equipment in the 900 MHz communication band.

DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a plastic SOT223 SMD package.

PINNING - SOT223

| PIN | SYMBOL | DESCRIPTION |
|-----|--------|-------------|
| 1 | e | emitter |
| 2 | b | base |
| 3 | e | emitter |
| 4 | c | collector |



QUICK REFERENCE DATA

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit (see Fig.7).

| MODE OF OPERATION | f (MHz) | V_{CE} (V) | P_L (W) | G_p (dB) | η_c (%) |
|-------------------------|------------|-----------------|--------------|---------------|-----------------|
| CW, class-B narrow band | 900 | 7.5 | 1.2 | ≥ 6 | ≥ 60 |
| | | 6 | 1.2 | typ. 6.5 | typ. 77 |

UHF power transistor

BLT81

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

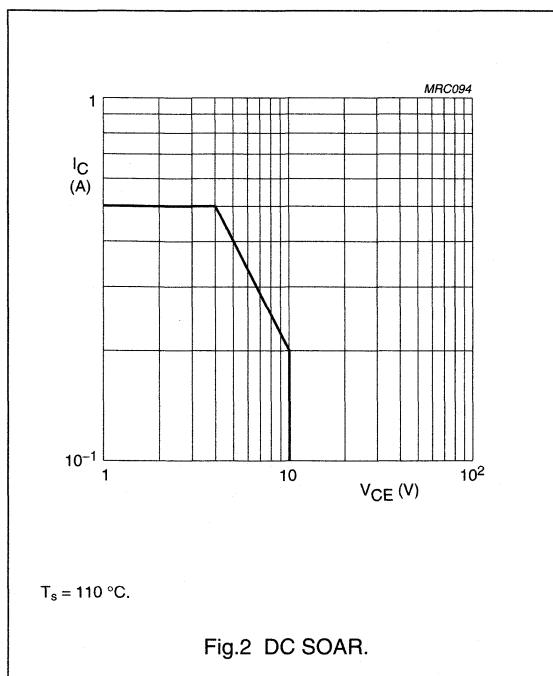
| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-------------|--------------------------------|--------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 9.5 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 2.5 | V |
| I_C | collector current (DC) | | – | 500 | mA |
| $I_{C(AV)}$ | average collector current | | – | 500 | mA |
| P_{tot} | total power dissipation | $T_s = 110\text{ °C}$; note 1 | – | 2 | W |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | operating junction temperature | | – | 175 | °C |

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | $P_{tot} = 2\text{ W}$; $T_s = 110\text{ °C}$; note 1 | 32 | K/W |

Note to the “Limiting values” and “Thermal characteristics”

- T_s is the temperature at the soldering point of the collector pin.



UHF power transistor

BLT81

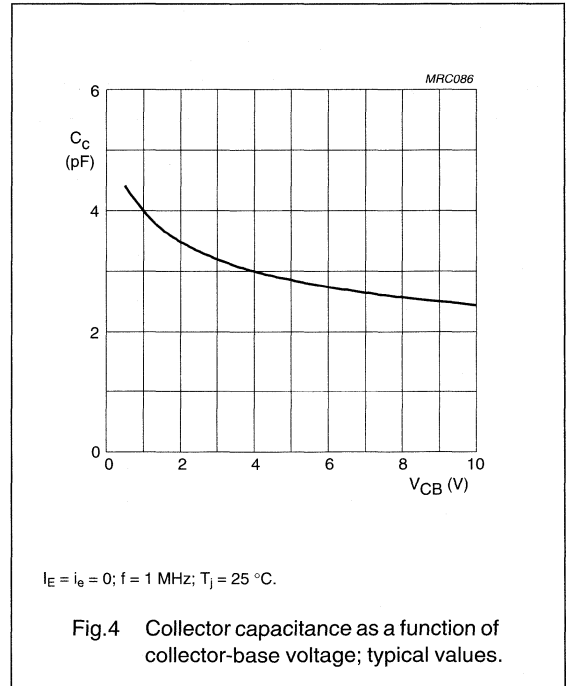
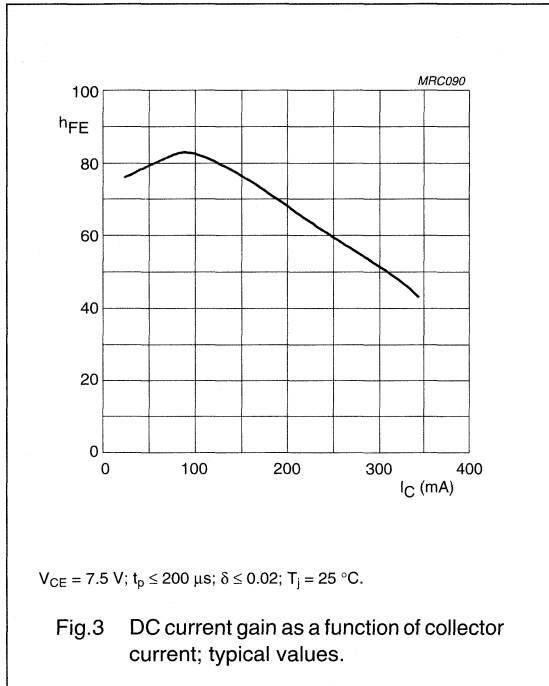
CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 1\text{ mA}$ | 20 | — | — | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 10\text{ mA}$ | 9.5 | — | — | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 0.1\text{ mA}$ | 2.5 | — | — | V |
| I_{CES} | collector leakage current | $V_{CE} = 10\text{ V}$; $V_{BE} = 0$ | — | — | 0.1 | mA |
| h_{FE} | DC current gain | $V_{CE} = 5\text{ V}$; $I_C = 300\text{ mA}$; note 1; | 25 | — | — | |
| C_c | collector capacitance | $V_{CB} = 7.5\text{ V}$; $I_E = i_e = 0$; $f = 1\text{ MHz}$; | — | 2.7 | 4 | pF |
| C_{re} | feedback capacitance | $V_{CE} = 7.5\text{ V}$; $I_C = 0$; $f = 1\text{ MHz}$ | — | 1.7 | 3 | pF |

Note

1. Measured under pulsed conditions: $t_p \leq 200\text{ }\mu\text{s}$; $\delta \leq 0.02$.



UHF power transistor

BLT81

APPLICATION INFORMATION

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit (see note 1 and Fig.7).

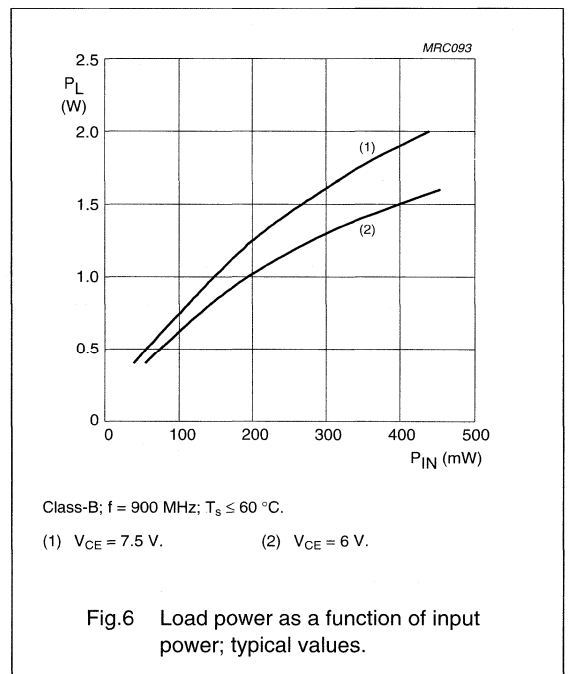
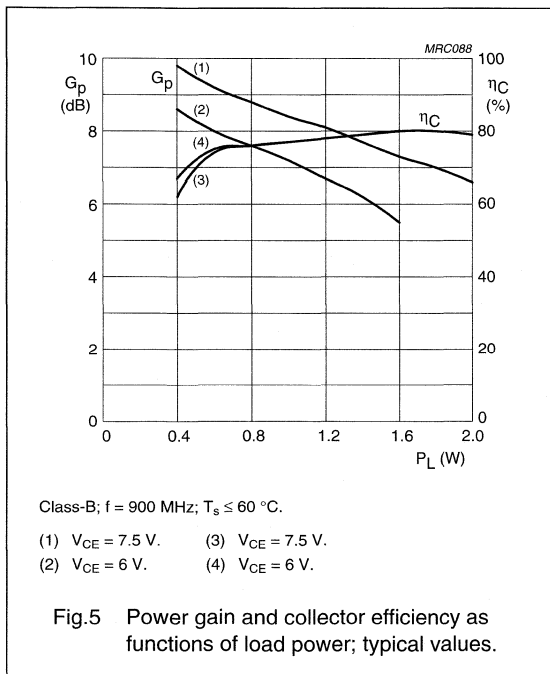
| MODE OF OPERATION | f (MHz) | V _{CE} (V) | P _L (W) | G _p (dB) | η_c (%) |
|-------------------------|---------|---------------------|--------------------|---------------------|----------------------|
| CW, class-B narrow band | 900 | 7.5 | 1.2 | ≥ 6 typ. 8 | ≥ 60 typ. 77 |
| | | 6 | 1.2 | typ. 6.5 | typ. 77 |

Note

1. T_s is the temperature at the soldering point of the collector pin.

Ruggedness in class-AB operation

The BLT81 is capable of withstanding a load mismatch corresponding to VSWR = 50 : 1 through all phases under the following conditions: f = 900 MHz; V_{CE} = 9 V; P_L = 1.2 W; $T_s \leq 60^\circ\text{C}$.



UHF power transistor

BLT81

List of components used in test circuit (see Figs 7 and 8)

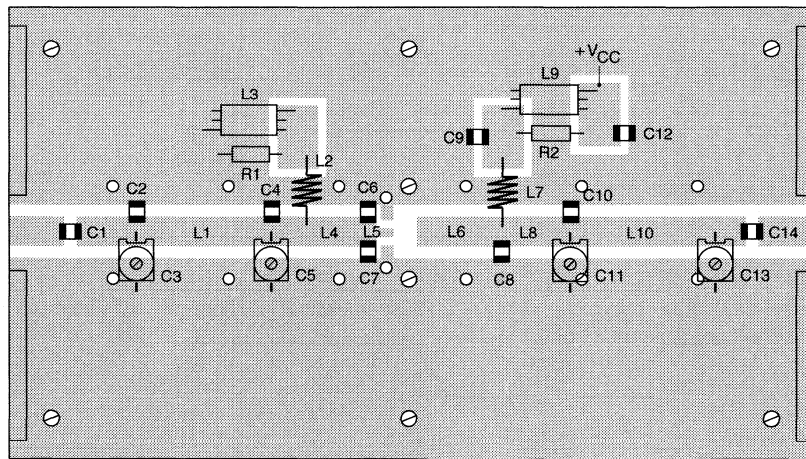
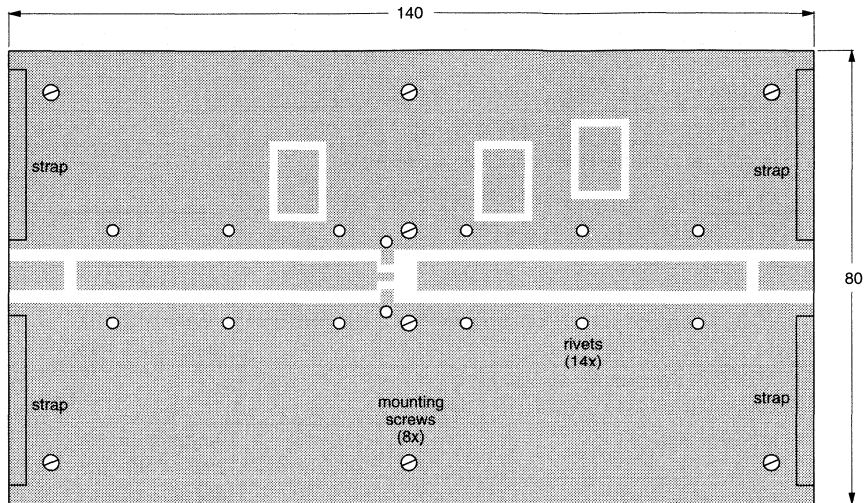
| COMPONENT | DESCRIPTION | VALUE | DIMENSIONS | CATALOGUE No. |
|------------------|---|----------------------|---|----------------|
| C1, C14 | multilayer ceramic chip capacitor; note 1 | 100 pF | | |
| C2 | multilayer ceramic chip capacitor; note 1 | 3 pF | | |
| C3, C5, C11, C13 | film dielectric trimmer | 1.4 to 5.5 pF | | 2222 809 09004 |
| C4 | multilayer ceramic chip capacitor; note 1 | 5.6 pF | | |
| C6, C7, C10 | multilayer ceramic chip capacitor; note 1 | 5.1 pF | | |
| C8 | multilayer ceramic chip capacitor; note 1 | 3.6 pF | | |
| C9 | multilayer ceramic chip capacitor; note 1 | 220 pF | | |
| C12 | multilayer ceramic chip capacitor; | 1 nF | | |
| L1 | stripline; note 2 | 50 Ω | length 26.6 mm width 4.85 mm | |
| L2 | 10 turns enamelled 0.6 mm copper wire | 250 nH | int. dia. 4.5 mm leads 2 \times 5 mm | |
| L3, L9 | grade 3B Ferroxcube wideband HF choke | | | 4312 020 36640 |
| L4 | stripline; note 2 | 50 Ω | length 18 mm width 4.85 mm | |
| L5 | stripline; note 2 | 75 Ω | length 3.5 mm width 2.5 mm | |
| L6 | stripline; note 2 | 50 Ω | length 10 mm width 4.85 mm | |
| L7 | 4 turns enamelled 0.6 mm copper wire | 65 nH | int. dia. 4.5 mm leads 2 \times 5 mm | |
| L8 | stripline; note 2 | 50 Ω | length 15 mm width 4.85 mm | |
| L10 | stripline; note 2 | 50 Ω | length 24.6 mm width 4.85 mm | |
| R1, R2 | metal film resistor | 10 Ω , 0.25 W | | |

Notes

- American Technical Ceramics type 100B or capacitor of same quality.
- The striplines are on a double copper-clad printed-circuit board, with PTFE fibre-glass dielectric ($\epsilon_r = 2.2$); thickness $\frac{1}{16}$ "; thickness of the copper sheet 35 μm .

UHF power transistor

BLT81



MEA898

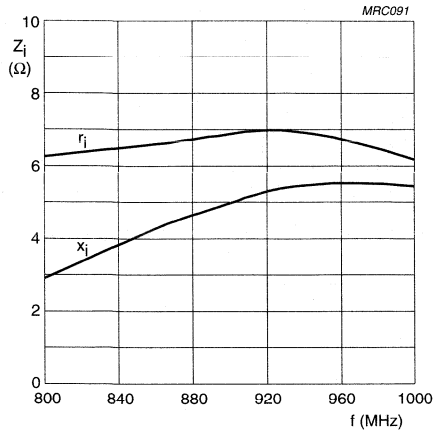
Dimensions in mm.

The components are situated on one side of the copper-clad PTFE fibre-glass board, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by means of fixing screws and copper foil straps under the emitter leads.

Fig.8 Printed-circuit board and component lay-out for 900 MHz class-B test circuit in Fig.7.

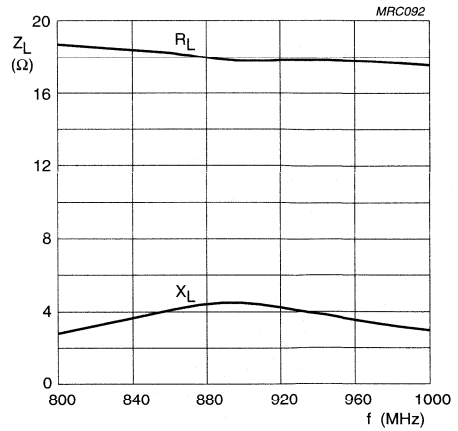
UHF power transistor

BLT81



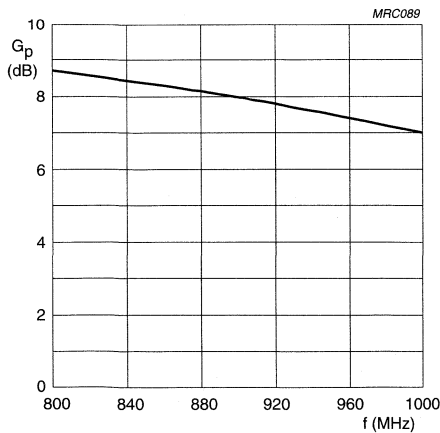
Class-B; $V_{CE} = 7.5$ V; $P_L = 1.2$ W; $T_s \leq 60$ °C.

Fig.9 Input impedance as a function of frequency (series components); typical values.



Class-B; $V_{CE} = 7.5$ V; $P_L = 1.2$ W; $T_s \leq 60$ °C.

Fig.10 Load impedance as a function of frequency (series components); typical values.



Class-B; $V_{CE} = 7.5$ V; $P_L = 1.2$ W; $T_s \leq 60$ °C.

Fig.11 Power gain as a function of frequency; typical values.

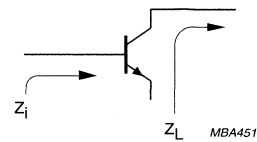


Fig.12 Definition of transistor impedance.

UHF power transistor

BLT82

FEATURES

- High efficiency
- High gain
- Internal pre-matched input.

APPLICATIONS

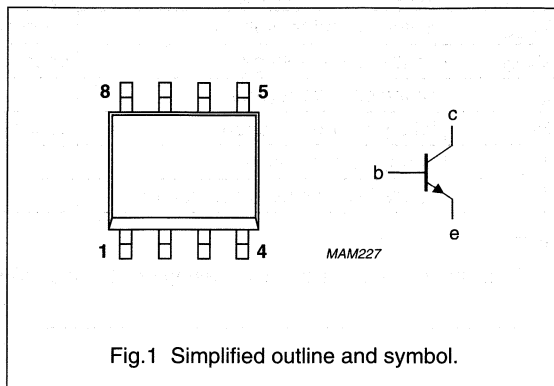
- Hand-held radio equipment in common emitter class-AB operation for 900 MHz Time Division Multiple Axis (TDMA) communication systems.

PINNING - SOT96-1

| PIN | SYMBOL | DESCRIPTION |
|------------|--------|-------------|
| 1, 8 | b | base |
| 2, 4, 5, 7 | e | emitter |
| 3, 6 | c | collector |

DESCRIPTION

NPN silicon planar epitaxial transistor encapsulated in a plastic SOT96-1 (SO8) SMD package.



QUICK REFERENCE DATA

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit (see Fig.5).

| MODE OF OPERATION | f (MHz) | V_{CE} (V) | P_L (W) | G_p (dB) | η_c (%) |
|-------------------|---------|--------------|-----------|---------------------|----------------------|
| Pulsed, class-AB | 900 | 6 | 3.5 | ≥ 8 typ. 10 | ≥ 50 typ. 65 |
| | | | 2.8 | ≥ 9 | ≥ 57 |

UHF power transistor

BLT82

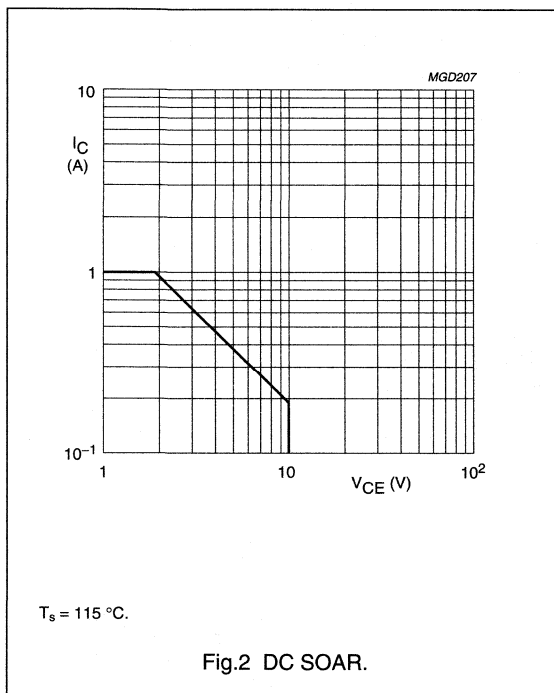
LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--------------------------------|--------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 10 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3.5 | V |
| I_C | collector current (DC) | | – | 1 | A |
| P_{tot} | total power dissipation | $T_s = 115\text{ °C}$; note 1 | – | 1.9 | W |
| T_{stg} | storage temperature | | –65 | +150 | °C |
| T_j | operating junction temperature | | – | 175 | °C |

Note

- T_s is the temperature at the soldering point of the collector pin.



UHF power transistor

BLT82

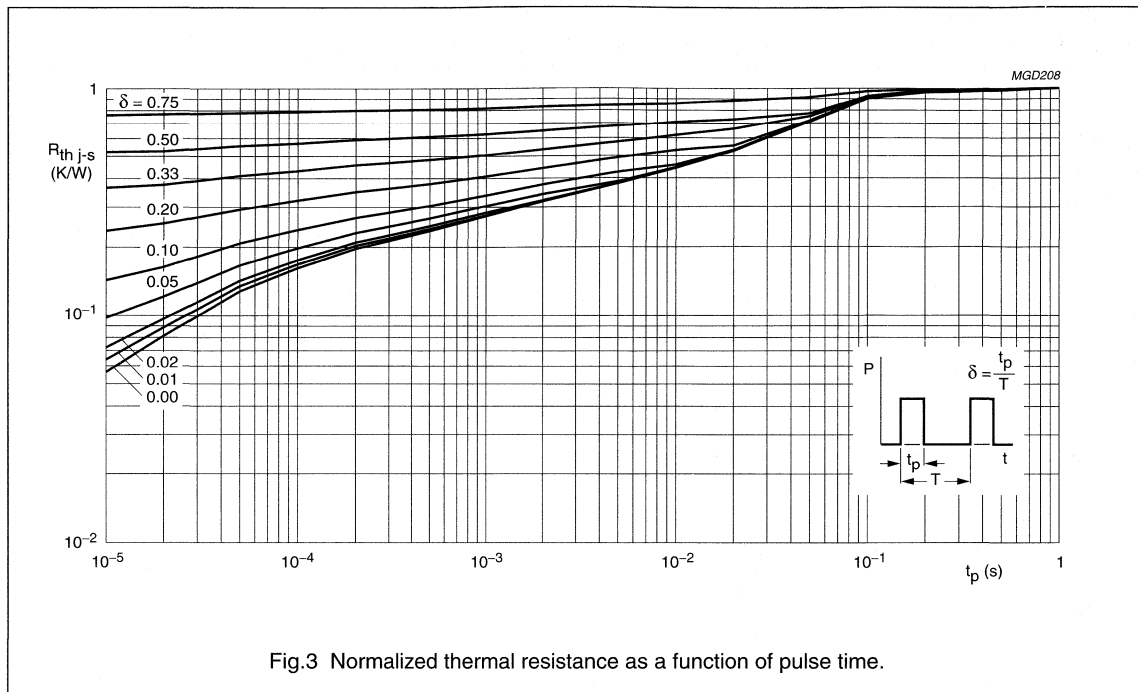


Fig.3 Normalized thermal resistance as a function of pulse time.

THERMAL CHARACTERISTICS

| SYMBOL | PARAMETER | CONDITIONS | VALUE | UNIT |
|---------------|---|---|-------|------|
| $R_{th\ j-s}$ | thermal resistance from junction to soldering point | $P_{tot} = 1.9\ W$; $T_s = 115\ ^\circ C$; note 1 | 32 | K/W |

Note

- T_s is the temperature at the soldering point of the collector pin.

CHARACTERISTICS

$T_j = 25\ ^\circ C$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | TYP. | MAX. | UNIT |
|---------------|-------------------------------------|--|------|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 5\ mA$ | 20 | — | — | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 10\ mA$ | 10 | — | — | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 1\ mA$ | 3.5 | — | — | V |
| I_{CES} | collector leakage current | $V_{CE} = 6\ V$; $V_{BE} = 0$ | — | — | 0.1 | mA |
| h_{FE} | DC current gain | $V_{CE} = 5\ V$; $I_C = 100\ mA$ | 30 | — | 150 | |
| C_c | collector capacitance | $V_{CB} = 6\ V$; $I_E = i_e = 0$; $f = 1\ MHz$ | — | 17 | — | pF |
| C_{re} | feedback capacitance | $V_{CE} = 6\ V$; $I_C = 0$; $f = 1\ MHz$ | — | 10 | — | pF |

UHF power transistor

BLT82

APPLICATION INFORMATION

RF performance at $T_s \leq 60^\circ\text{C}$ in a common emitter test circuit (see notes 1, 2 and Fig.5).

| MODE OF OPERATION | f (MHz) | V_{CE} (V) | I_{CQ} (mA) | P_L (W) | G_p (dB) | η_c (%) |
|---|---------|--------------|---------------|-----------|---------------------|----------------------|
| Pulsed, class-AB; $\delta = 1 : 8$; $t_p \leq 5$ ms | 900 | 6 | 2 | 3.5 | ≥ 8 typ. 10 | ≥ 50 typ. 65 |
| | | | | 2.8 | ≥ 9 | ≥ 57 |

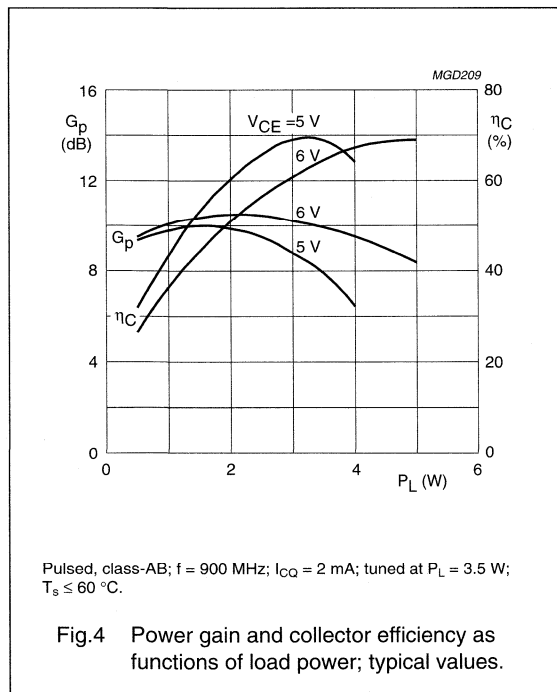
Notes

- T_s is the temperature at the soldering point of the collector pin.
- See also application report: "G.S.M. Power Amplifier for 900 MHz at 6 V (no.: RNR-T45-95-T-246)"

Ruggedness in class-AB operation

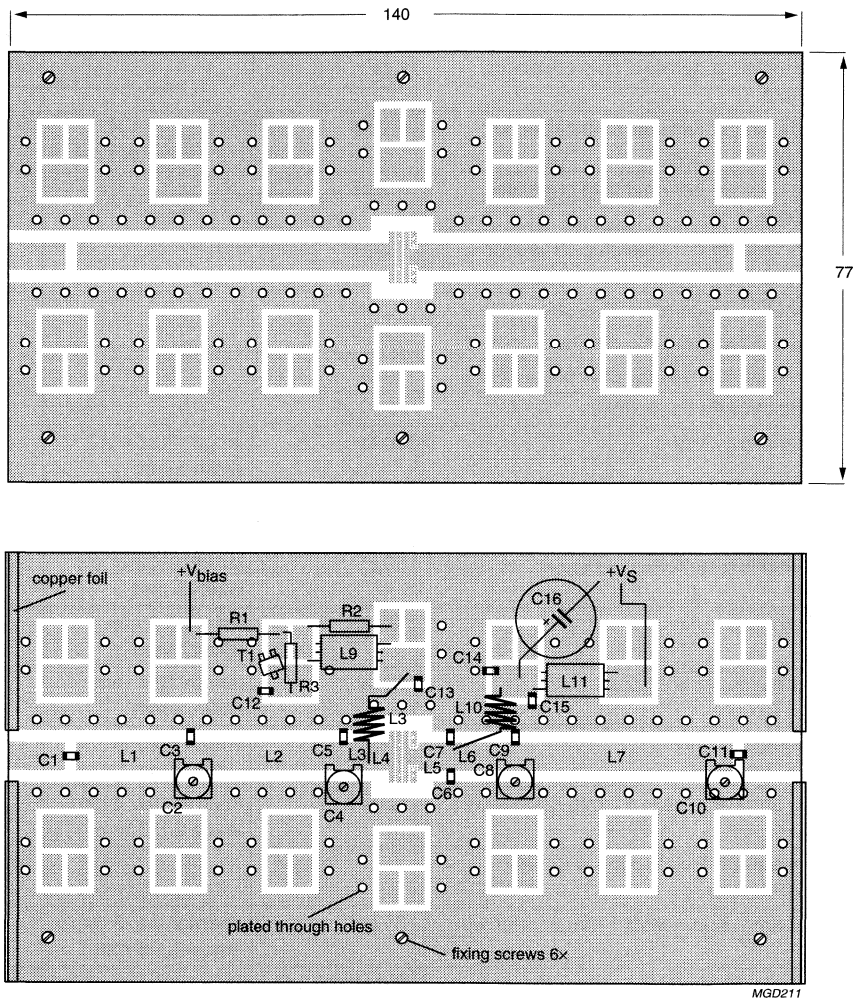
The BLT82 is capable of withstanding load mismatches corresponding to:

- VSWR = 6 : 1 through all phases under the following conditions: $\delta = 1 : 8$; $t_p \leq 5$ ms; $f = 900$ MHz; $V_{CE} = 8.3$ V; $P_L = 4$ W.
- VSWR = 10 : 1 through all phases under the following conditions: $\delta = 1 : 8$; $t_p \leq 5$ ms; $f = 900$ MHz; $V_{CE} = 8.6$ V; $P_L = 2.8$ W.



UHF power transistor

BLT82



MGD211

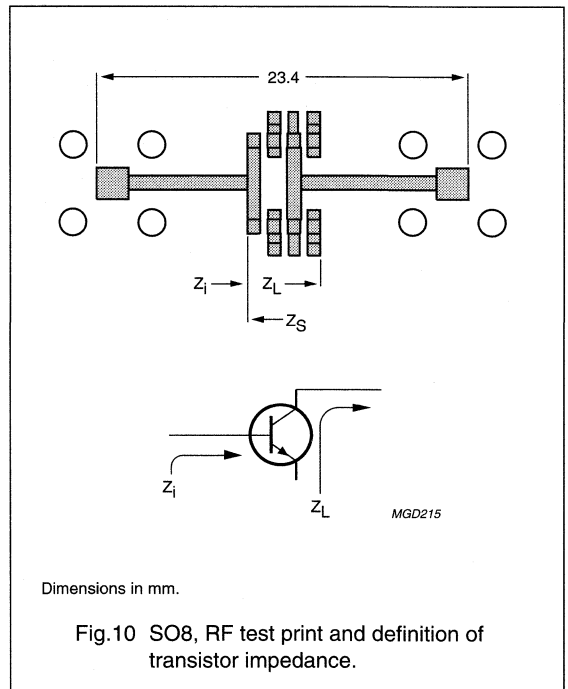
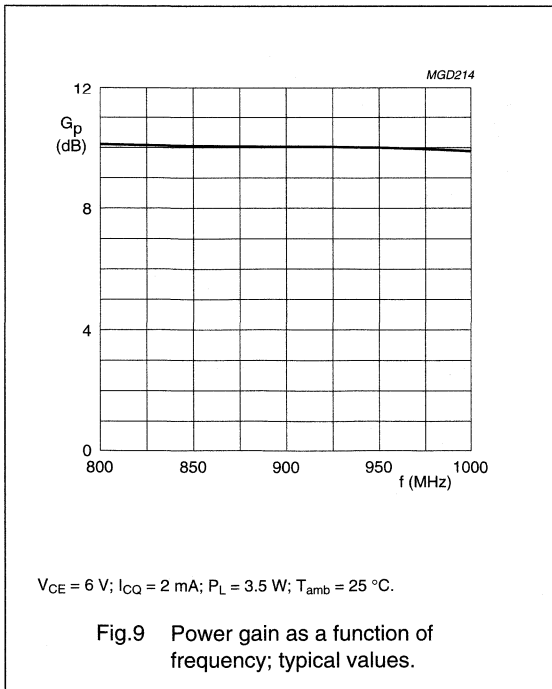
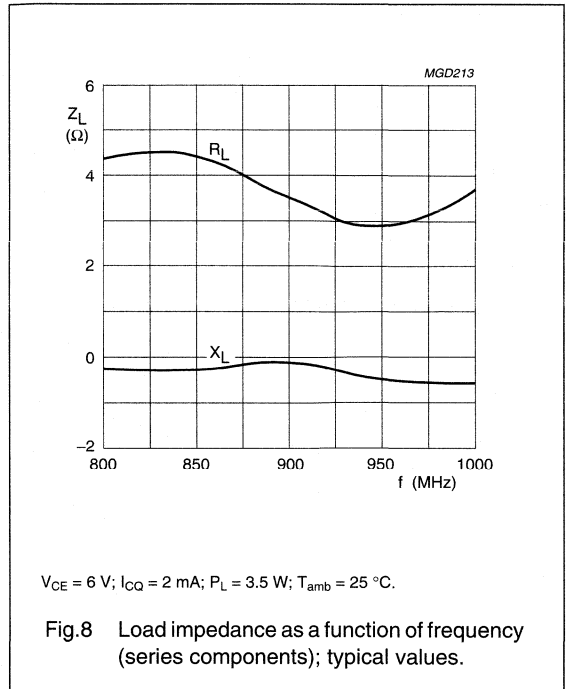
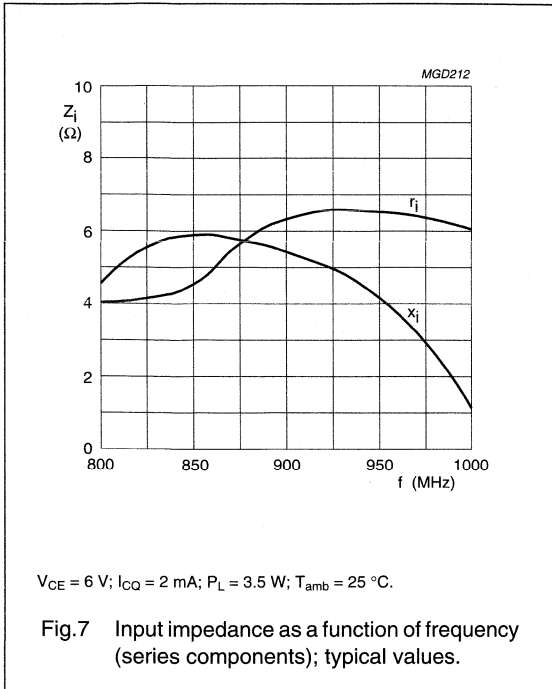
Dimensions in mm.

The components are situated on one side of the copper-clad PCB, the other side is unetched and serves as a ground plane. Earth connections from the component side to the ground plane are made by fixing screws, through metallization and copper straps around the board.

Fig.6 Printed-circuit board and component lay-out for 900 MHz class-AB test circuit in Fig.5.

UHF power transistor

BLT82



UHF power transistor

BLT92/SL

DESCRIPTION

NPN silicon planar epitaxial transistor primarily intended for use in handheld radio stations in the 900 MHz communications band.

This device has been designed specifically for class-B operation.

FEATURES

- internal input matching capacitor for a high power gain
- gold metallization ensures excellent reliability

The transistor has a 4-lead studless envelope with a ceramic cap (SOT122D). All leads are isolated from the mounting base.

PINNING

- 1 = collector
2 = emitter
3 = base
4 = emitter

QUICK REFERENCE DATA

RF performance at $T_{mb} = 25\text{ }^{\circ}\text{C}$ in a common-emitter class-B circuit

| MODE OF OPERATION | V_{CE} (V) | f (MHz) | P_L (W) | G_p (dB) | η_c (%) |
|-------------------|-----------------|------------|--------------|---------------|-----------------|
| CW (class-B) | 7.5 | 900 | 3.0 | > 7.0 | > 50 |

PIN CONFIGURATION

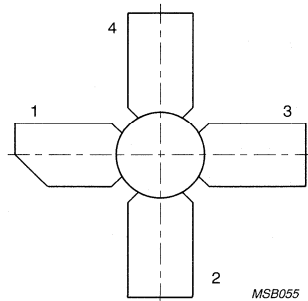


Fig.1 Simplified outline, SOT122D.

PRODUCT SAFETY This device incorporates beryllium oxide (BeO), the dust of which is toxic. The device is entirely safe provided that the internal BeO disc is not damaged.

UHF power transistor

BLT92/SL

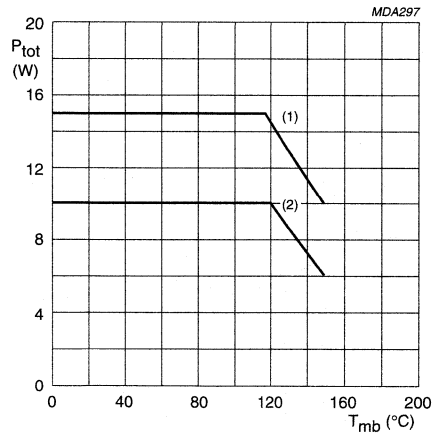
RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| | | | |
|---------------------------------------|------------------|------|----------------|
| Collector-base voltage (open emitter) | V_{CBO} | max. | 20 V |
| Collector-emitter voltage (open base) | V_{CEO} | max. | 10 V |
| Emitter-base voltage (open collector) | V_{EBO} | max. | 3.0 V |
| Collector current | | | |
| DC or average | $I_C; I_{C(AV)}$ | max. | 1.2 A |
| (peak value); $f > 800$ MHz | I_{CM} | max. | 3.6 A |
| Total power dissipation | | | |
| at $T_{amb} < 120$ °C; $f > 800$ MHz | P_{tot} | max. | 10 W |
| Storage temperature range | T_{stg} | | -65 to +150 °C |
| Operating junction temperature | T_j | max. | 200 °C |

THERMAL RESISTANCEDissipation = 10 W; $T_{mb} = 25$ °C

| | | | |
|---|--------------------|------|---------|
| From junction to mounting base ($f > 800$ MHz) | $R_{th\ j-mb(RF)}$ | max. | 6.0 K/W |
|---|--------------------|------|---------|



- (1) Short-time RF operation during mismatch ($f > 800$ MHz).
 (2) Continuous RF operation ($f > 800$ MHz).

Fig.2 Total power dissipation as a function of temperature.

UHF power transistor

BLT92/SL

CHARACTERISTICS

$T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified

Collector-base breakdown voltage

open emitter; $I_C = 10\text{ mA}$

$V_{(BR)CBO} > 20\text{ V}$

Collector-emitter breakdown voltage

open base; $I_C = 20\text{ mA}$

$V_{(BR)CEO} > 10\text{ V}$

Emitter-base breakdown voltage

open collector; $I_E = 2\text{ mA}$

$V_{(BR)EBO} > 3.0\text{ V}$

Collector cut-off current

$V_{BE} = 0$; $V_{CE} = 10\text{ V}$

$I_{CES} < 5.0\text{ mA}$

Second breakdown energy

$L = 25\text{ mH}$; $f = 50\text{ Hz}$; $R_{BE} = 10\text{ }\Omega$

$E_{SBR} > 1.0\text{ mJ}$

DC current gain

$I_C = 600\text{ mA}$; $V_{CE} = 5\text{ V}$

$h_{FE} > 25$

Collector capacitance at $f = 1\text{ MHz}$

$I_E = i_e = 0$; $V_{CB} = 7.5\text{ V}$

C_c typ. 11 pF

Feedback capacitance at $f = 1\text{ MHz}$

$I_C = 0$; $V_{CE} = 7.5\text{ V}$

C_{re} typ. 6.0 pF

Collector-mounting base capacitance

C_{c-mb} typ. 1.2 pF

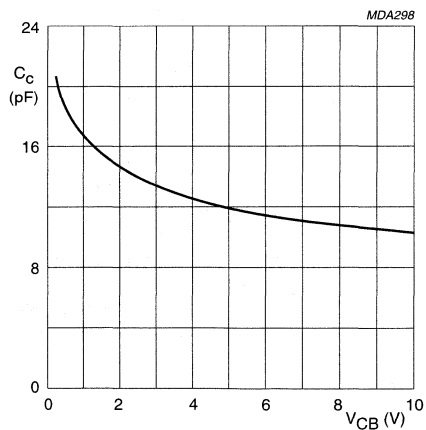


Fig.3 Collector capacitance as a function of collector-base voltage; $f = 1\text{ MHz}$; $I_E = i_e = 0$; typical values.

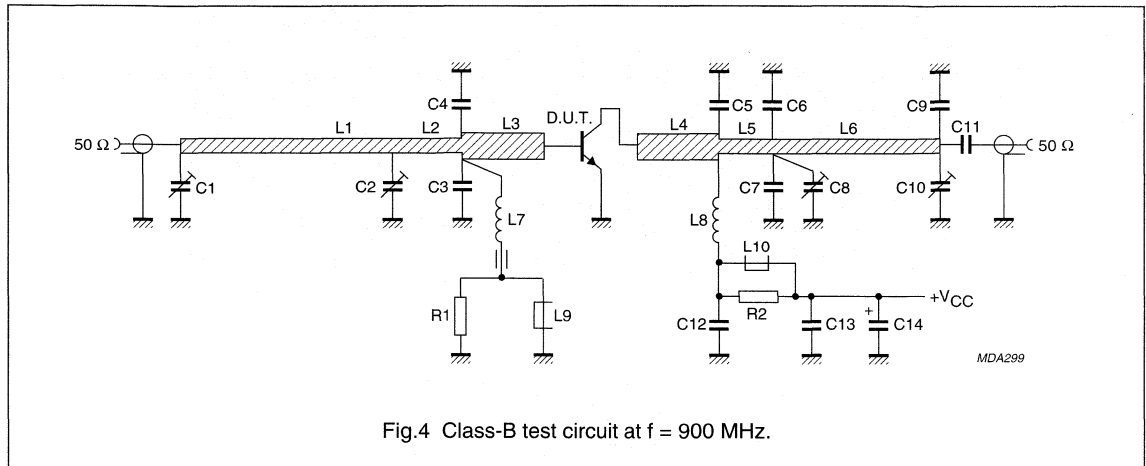
UHF power transistor

BLT92/SL

APPLICATION INFORMATION

RF performance in CW operation (common-emitter circuit; class-B); $f = 900 \text{ MHz}$; $T_{mb} = 25 \text{ }^\circ\text{C}$

| MODE OF OPERATION | V_{CE} (V) | P_L (W) | G_p (dB) | η_c (%) |
|-------------------|-----------------|--------------|-------------------|-----------------|
| Class-B; CW | 7.5 | 3.0 | > 7.0 typ. 8.5 | > 50 typ. 57 |

Fig.4 Class-B test circuit at $f = 900 \text{ MHz}$.

List of components:

- C1 = C2 = C8 = C10 = 1.4 to 5.5 pF film dielectric trimmer (cat. no. 2222 809 09001)
- C3 = C6 = C7 = 3.3 pF multilayer ceramic chip capacitor⁽¹⁾
- C4 = C5 = C9 = 5.6 pF multilayer ceramic chip capacitor⁽¹⁾
- C11 = C12 = C13 = 180 pF multilayer ceramic chip capacitor
- C14 = 1 μF (35 V) tantalum capacitor
- L1 = 50 Ω stripline (25 mm \times 2.4 mm)
- L2 = 50 Ω stripline (11 mm \times 2.4 mm)
- L3 = L4 = 25 Ω stripline (11.5 mm \times 6.0 mm)
- L5 = 50 Ω stripline (7.0 mm \times 2.4 mm)
- L6 = 50 Ω stripline (27.0 mm \times 2.4 mm)
- L7 = 4 turns closely wound enamelled Cu wire (0.4 mm), int. dia.: 3 mm, with ferrite bead (cat. no. 4330 830 32221) over the coldside lead
- L8 = 1 turn Cu wire (1.0 mm); int. dia. 5.5 mm; length 2 mm; leads 2 \times 5 mm
- L9 = L10 = Ferroxcube wideband HF choke, grade 3B (cat. no. 4312 020 36642)
- R1 = R2 = 10 $\Omega \pm 5\%$; 0.25 W metal film resistor

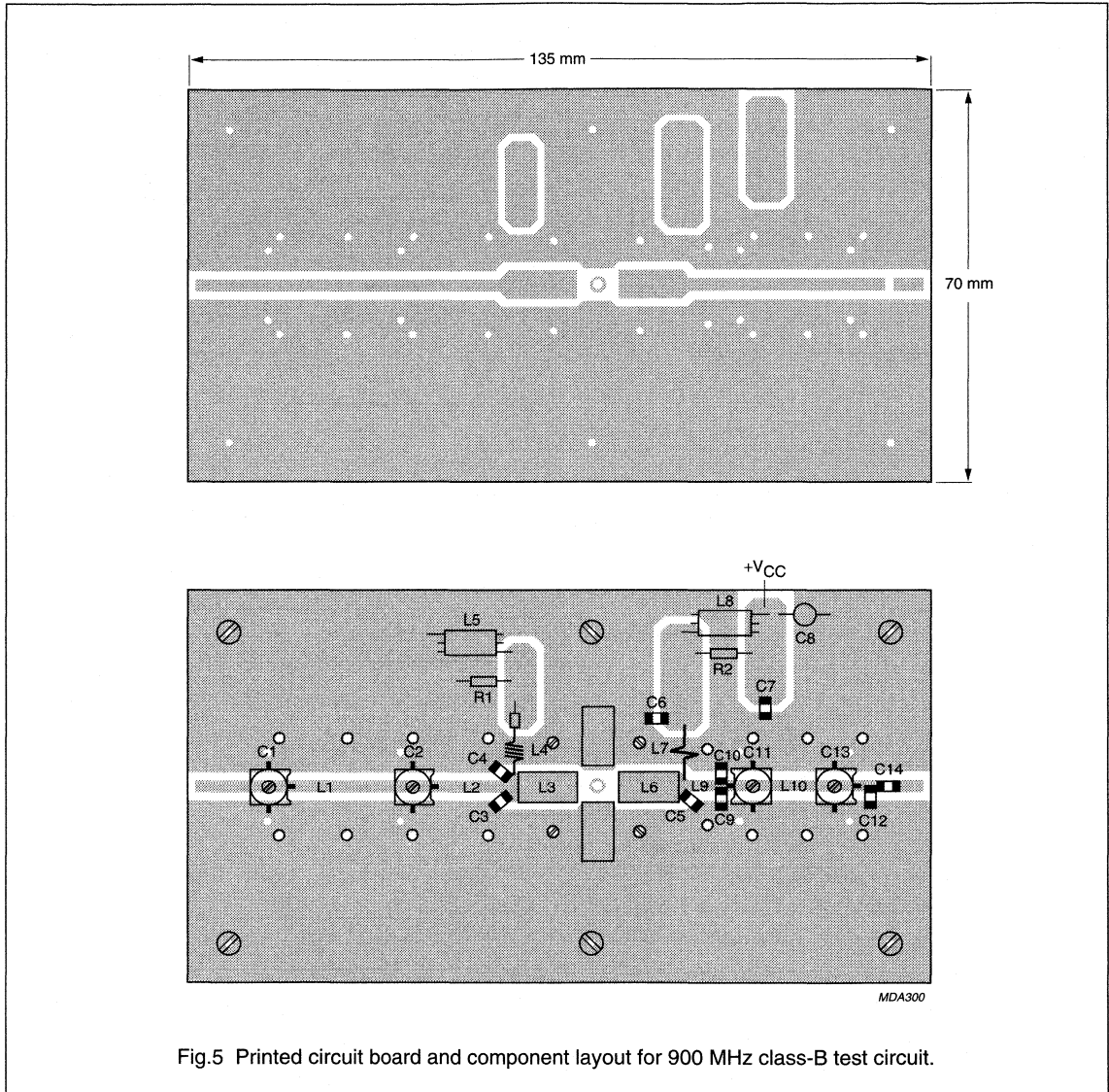
The striplines on a double Cu-clad printed circuit board with PTFE fibreglass dielectric ($\epsilon_r = 2.2$); thickness 1/32 inch; thickness of copper-sheet 2 \times 35 μm .

Note

1. American Technical Ceramics capacitor type 100 A or capacitor of same quality.

UHF power transistor

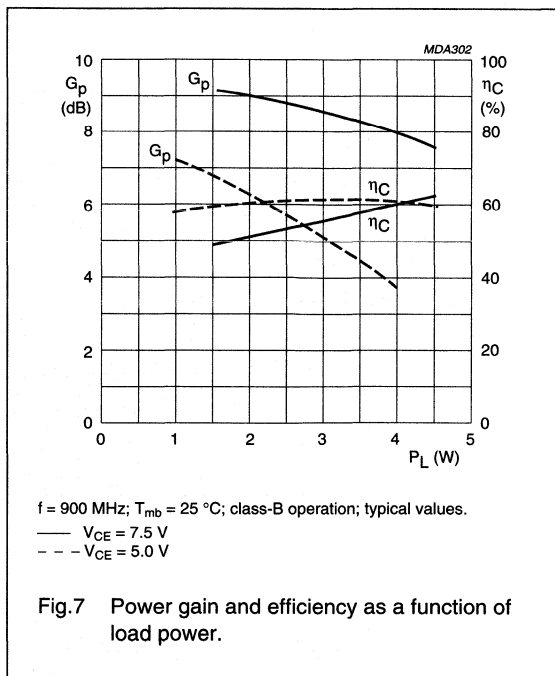
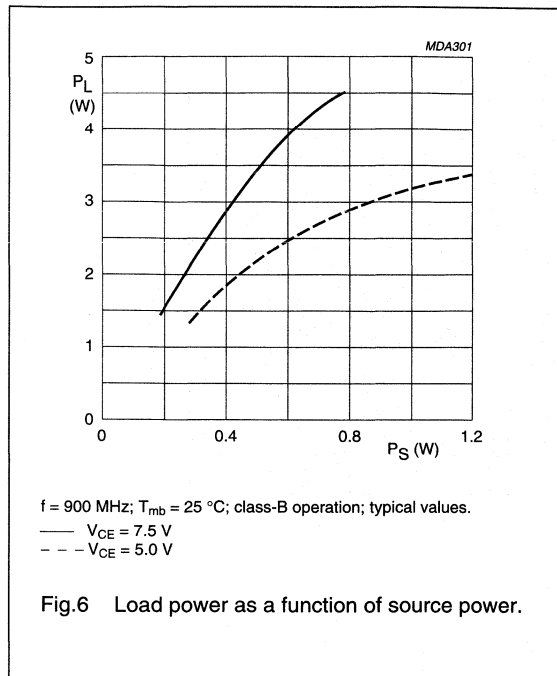
BLT92/SL

**Note:**

The circuit and the components are on one side of the PTFE fibreglass board; the other side is un-etched copper serving as groundplane. Earth connections are made by hollow rivets and also by fixing-screws and copper straps around the board and under the emitters to provide a direct contact between the copper on the component side and the groundplane.

UHF power transistor

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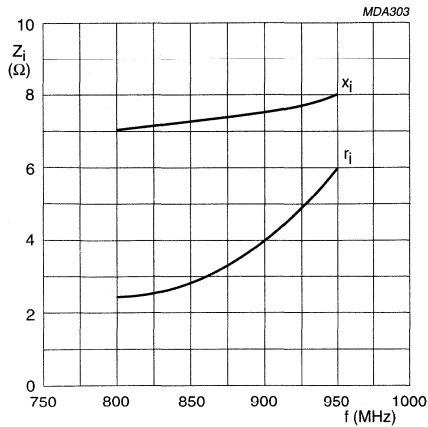


RUGGEDNESS

The device is capable of withstanding a full load mismatch (VSWR = 50; all phases) at rated load power up to a supply voltage of 9.0 V at $T_{mb} = 25$ °C.

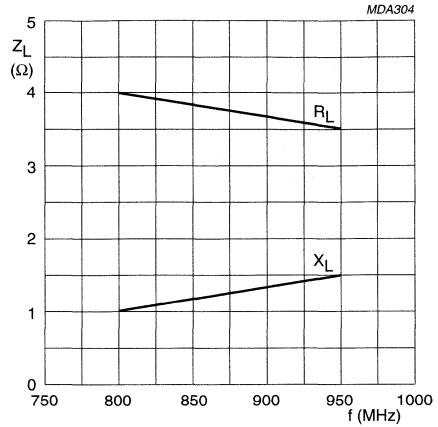
UHF power transistor

BLT92/SL



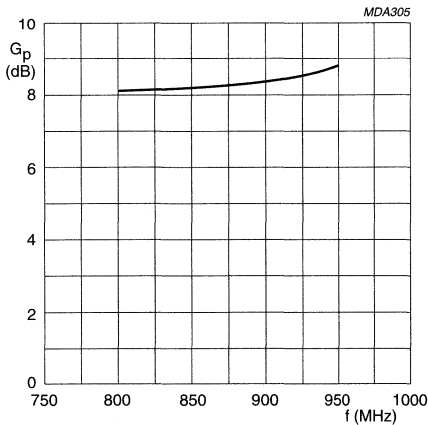
$V_{CE} = 7,5 \text{ V}$; $P_L = 3 \text{ W}$; $f = 800 - 960 \text{ MHz}$; $T_{mb} = 25 \text{ }^\circ\text{C}$;
class-B operation; typical values.

Fig.8 Input impedance as a function of frequency (series components).



$V_{CE} = 7,5 \text{ V}$; $P_L = 3 \text{ W}$; $f = 800 - 960 \text{ MHz}$; $T_{mb} = 25 \text{ }^\circ\text{C}$;
class-B operation; typical values.

Fig.9 Load impedance as a function of frequency (series components).



$V_{CE} = 7,5 \text{ V}$; $P_L = 3 \text{ W}$; $f = 800 - 960 \text{ MHz}$; $T_{mb} = 25 \text{ }^\circ\text{C}$;
class-B operation; typical values.

Fig.10 Power gain as a function of frequency.

NPN 1 GHz general purpose switching transistor

MPSH10

FEATURES

- Low cost
- High power gain.

DESCRIPTION

Silicon NPN general purpose transistor in a SOT54 (TO-92) envelope.

PINNING

| PIN | DESCRIPTION |
|-----|-------------|
| 1 | collector |
| 2 | emitter |
| 3 | base |

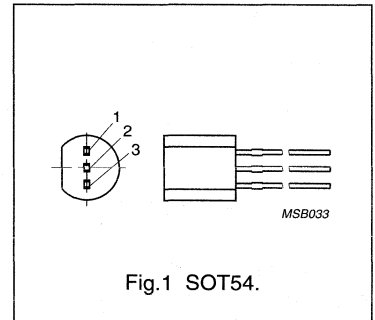


Fig.1 SOT54.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--|--|------|------|------|
| V_{CB0} | collector-base voltage | open emitter | – | 30 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| P_{tot} | total power dissipation | $T_s = 25\text{ °C}$ (note 1) | – | 1 | W |
| T_j | junction temperature | | – | 150 | °C |
| h_{FE} | DC current gain | $V_{CE} = 10\text{ V}; I_C = 4\text{ mA}$ | 60 | – | |
| C_{re} | collector-emitter feedback capacitance | $V_{CB} = 10\text{ V}; I_E = 0; f = 1\text{ MHz}$ | – | 0.7 | pF |
| C_{rb} | collector-base feedback capacitance | $V_{CB} = 10\text{ V}; I_E = 0; f = 1\text{ MHz}$ | 0.35 | 0.65 | pF |
| f_T | transition frequency | $V_{CE} = 10\text{ V}; I_C = 4\text{ mA};$ $f = 100\text{ MHz}; T_{amb} = 25\text{ °C}$ | 650 | – | MHz |
| $r_b C_C$ | collector-base time constant | $V_{CE} = 10\text{ V}; I_C = 4\text{ mA};$ $f = 100\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 9 | ps |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------|------|------|------|
| V_{CB0} | collector-base voltage | open emitter | – | 30 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| I_C | DC collector current | | – | 40 | mA |
| P_{tot} | total power dissipation | $T_s = 25\text{ °C}$ (note 1) | – | 1 | W |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 150 | °C |

Note

1. T_s is the temperature at the soldering point of the collector lead, 4 mm from the body.

NPN 1 GHz general purpose switching transistor

MPSH10

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 125 K/W |
| $R_{th\ j-a}$ | from junction to ambient | 250 K/W |

Note

- T_s is the temperature at the soldering point of the collector lead, 4 mm from the body.

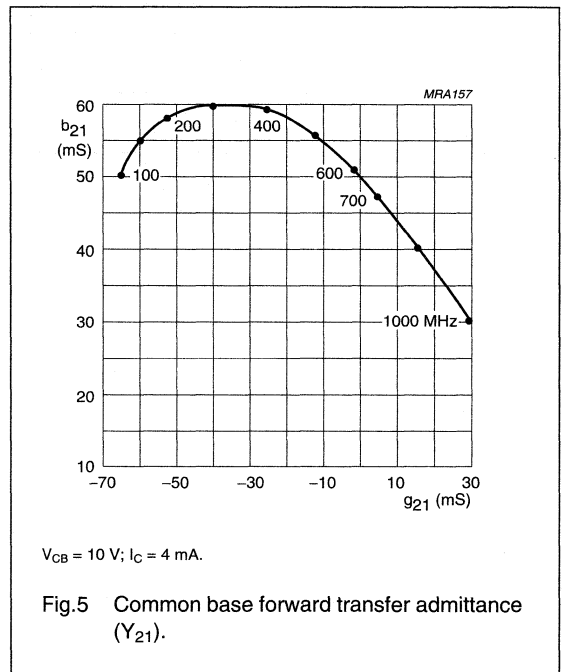
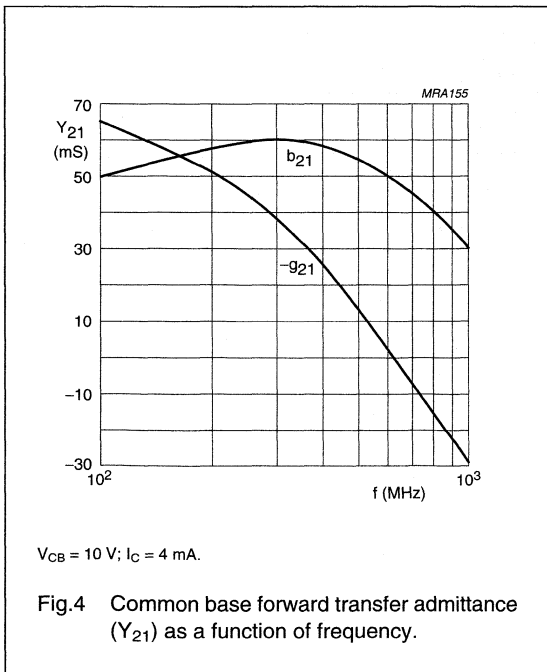
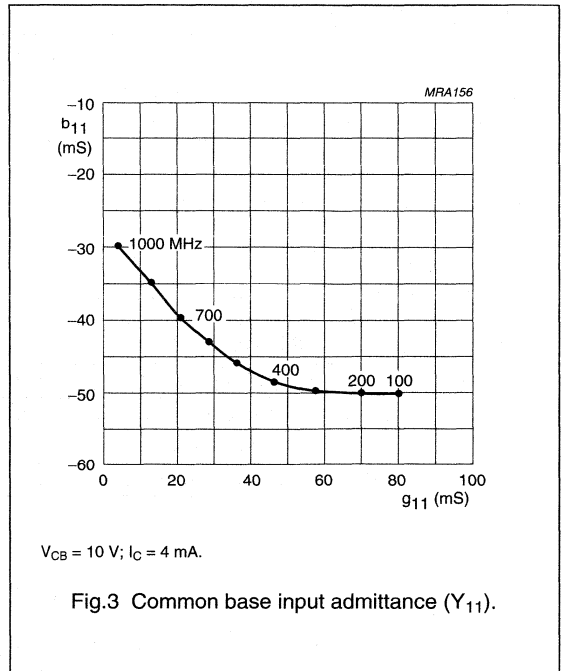
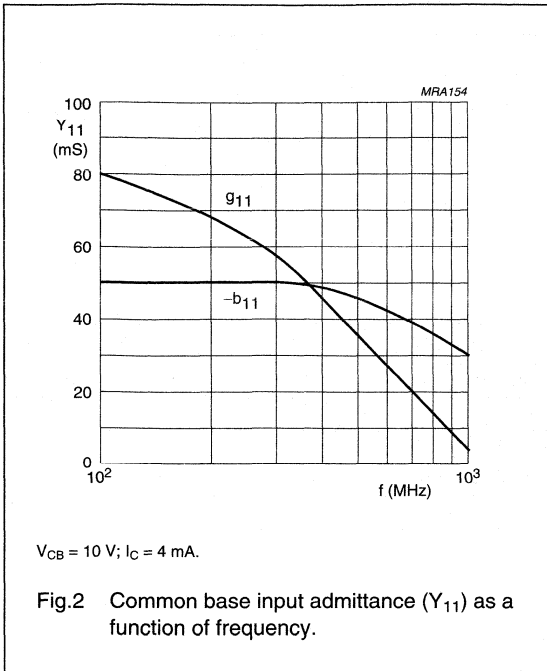
CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|--|--|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 100\ \mu\text{A}$; $I_E = 0$ | 30 | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 1\ \text{mA}$; $I_B = 0$ | 25 | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 10\ \mu\text{A}$; $I_C = 0$ | 3 | – | V |
| $V_{CE\ sat}$ | collector-emitter saturation voltage | $I_C = 4\ \text{mA}$; $I_B = 0.4\ \text{mA}$ | – | 0.5 | V |
| $V_{BE\ on}$ | base-emitter ON voltage | $V_{CE} = 10\ \text{V}$; $I_C = 4\ \text{mA}$ | – | 0.95 | V |
| I_{CBO} | collector-base cut-off current | $V_{CB} = 25\ \text{V}$; $I_E = 0$ | – | 100 | nA |
| I_{EBO} | emitter-base cut-off current | $V_{CB} = 25\ \text{V}$; $I_C = 0$ | – | 100 | nA |
| h_{FE} | DC current gain | $V_{CE} = 10\ \text{V}$; $I_C = 4\ \text{mA}$ | 60 | – | |
| C_{re} | collector-emitter feedback capacitance | $V_{CB} = 10\ \text{V}$; $I_E = i_e = 0$; $f = 1\ \text{MHz}$ | – | 0.7 | pF |
| C_{rb} | collector-base feedback capacitance | $V_{CB} = 10\ \text{V}$; $I_C = i_c = 0$; $f = 1\ \text{MHz}$ | 0.35 | 0.65 | pF |
| f_T | transition frequency | $V_{CE} = 10\ \text{V}$; $I_C = 4\ \text{mA}$; $f = 100\ \text{MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 650 | – | MHz |
| r_{bC_c} | collector-base time constant | $V_{CB} = 10\ \text{V}$; $I_C = 4\ \text{mA}$; $f = 100\ \text{MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 9 | ps |

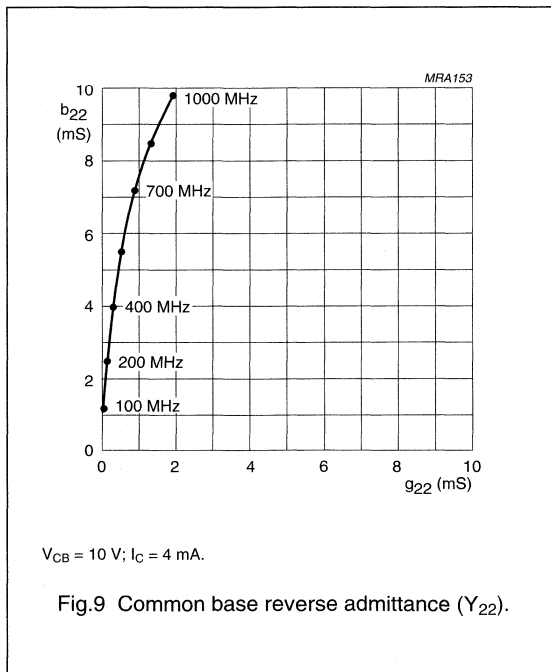
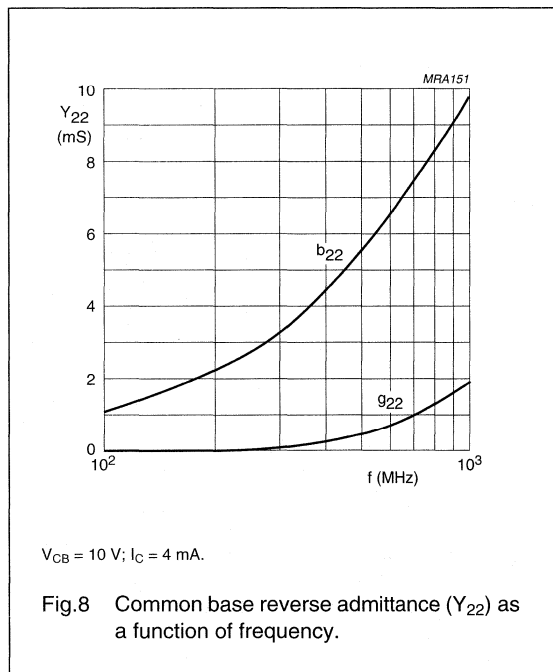
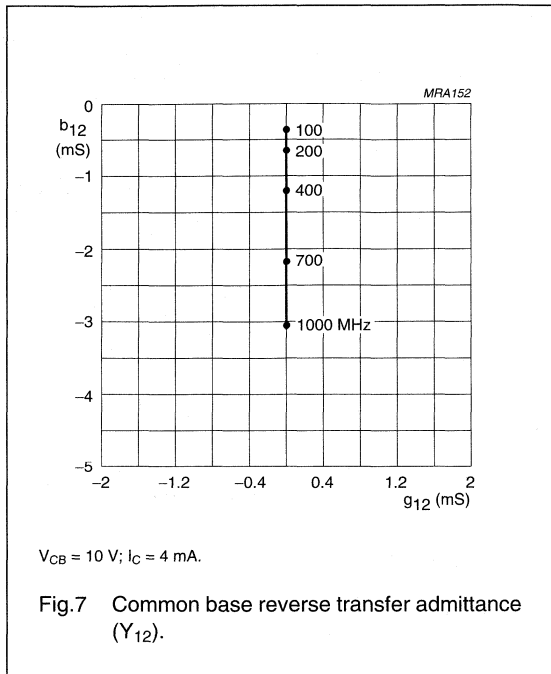
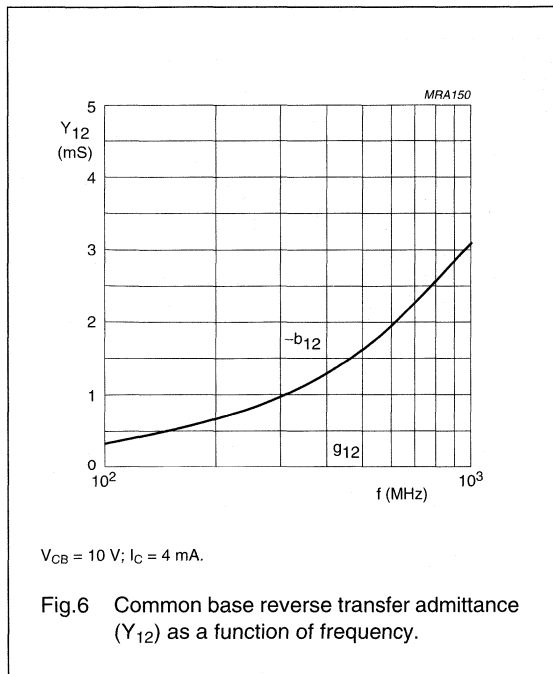
NPN 1 GHz general purpose switching transistor

MPSH10



NPN 1 GHz general purpose switching transistor

MPSH10



PNP 1 GHz switching transistor

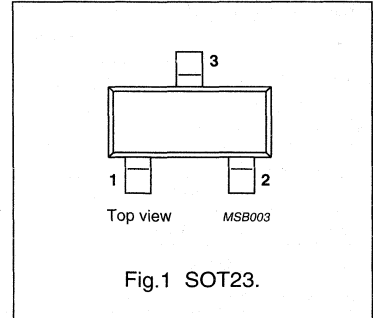
PMBT3640

DESCRIPTION

PNP general purpose switching transistor in a SOT23 package.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: V25 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|------------|---------------------------|---|------|------|------------------|
| $-V_{CBO}$ | collector-base voltage | open emitter | - | 12 | V |
| $-V_{CEO}$ | collector-emitter voltage | open base | - | 12 | V |
| $-V_{EBO}$ | emitter-base voltage | open collector | - | 4 | V |
| $-I_C$ | DC collector current | | - | 80 | mA |
| P_{tot} | total power dissipation | up to $T_s = 85\text{ }^\circ\text{C}$ (note 1) | - | 350 | mW |
| T_{stg} | storage temperature | | -55 | 150 | $^\circ\text{C}$ |
| T_j | junction temperature | | - | 175 | $^\circ\text{C}$ |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 260 K/W |

Note

1. T_s is the temperature at the soldering point of the collector tab.

PNP 1 GHz switching transistor

PMBT3640

CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$ unless otherwise specified.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|--|--------------------------------------|---|------|------|---------------|
| Off characteristics | | | | | |
| $-V_{(BR)CBO}$ | collector-base breakdown voltage | $-I_C = 100\text{ }\mu\text{A}; I_E = 0$ | 12 | – | V |
| $-V_{(BR)CES}$ | collector-emitter breakdown voltage | $-I_C = 100\text{ }\mu\text{A}; V_{BE} = 0$ | 12 | – | V |
| $-V_{(BR)EBO}$ | emitter-base breakdown voltage | $-I_E = 100\text{ }\mu\text{A}; I_C = 0$ | 4 | – | V |
| $-I_{CES}$ | collector cut-off current | $-V_{CE} = 6\text{ V}; V_{BE} = 0$ | – | 0.01 | μA |
| | | $-V_{CE} = 6\text{ V}; V_{BE} = 0; T_{amb} = 65\text{ }^\circ\text{C}$ | – | 1 | μA |
| $-I_B$ | base current | $-V_{CE} = 6\text{ V}; V_{BE} = 0$ | – | 10 | nA |
| On characteristics; pulse test: pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$. | | | | | |
| h_{FE} | DC current gain | $-I_C = 10\text{ mA}; -V_{CE} = 0.3\text{ V}$ | 30 | 120 | |
| | | $-I_C = 50\text{ mA}; -V_{CE} = 1\text{ V}$ | 20 | – | |
| $-V_{CEsat}$ | collector-emitter saturation voltage | $-I_C = 10\text{ mA}; -I_B = 1\text{ mA}$ | – | 0.2 | V |
| | | $-I_C = 50\text{ mA}; -I_B = 5\text{ mA}$ | – | 0.6 | V |
| | | $-I_C = 10\text{ mA}; -I_B = 1\text{ mA}; T_{amb} = 65\text{ }^\circ\text{C}$ | – | 0.25 | V |
| $-V_{BEsat}$ | base-emitter saturation voltage | $-I_C = 10\text{ mA}; -I_B = 0.5\text{ mA}$ | 0.75 | 0.95 | V |
| | | $-I_C = 10\text{ mA}; -I_B = 1\text{ mA}$ | 0.8 | 1 | V |
| | | $-I_C = 50\text{ mA}; -I_B = 5\text{ mA}$ | – | 1.5 | V |
| Small-signal characteristics | | | | | |
| f_T | transition frequency | $-I_C = 10\text{ mA}; -V_{CE} = 5\text{ V};$ $f = 100\text{ MHz}$ | 500 | – | MHz |
| C_c | output capacitance | $I_E = 0; -V_{CB} = 5\text{ V}; f = 1\text{ MHz}$ | – | 3.5 | pF |
| C_e | input capacitance | $I_C = 0; -V_{EB} = 0.5\text{ V}; f = 1\text{ MHz}$ | – | 3.5 | pF |
| Switching times | | | | | |
| t_d | delay time | $-V_{CC} = 6\text{ V}; -I_C = 50\text{ mA};$ $-V_{BE(off)} = 1.9\text{ V}; -I_{B1} = 5\text{ mA}$ | – | 10 | ns |
| t_s | storage time | $-V_{CC} = 6\text{ V}; -I_C = 50\text{ mA};$ $-I_{B1} = -I_{B2} = 5\text{ mA}$ | – | 20 | ns |
| t_r | rise time | $-V_{CC} = 6\text{ V}; -I_C = 50\text{ mA};$ $-V_{BE(off)} = 1.9\text{ V}; -I_{B1} = 5\text{ mA}$ | – | 30 | ns |
| t_f | fall time | $-V_{CC} = 6\text{ V}; -I_C = 50\text{ mA};$ $-I_{B1} = -I_{B2} = 5\text{ mA}$ | – | 12 | ns |
| t_{on} | turn-on time | $-V_{CC} = 6\text{ V}; -I_C = 50\text{ mA};$ $-V_{BE(off)} = 1.9\text{ V}; -I_{B1} = 5\text{ mA}$ | – | 25 | ns |
| | | $-V_{CC} = 1.5\text{ V}; -I_C = 10\text{ mA};$ $-I_{B1} = 0.5\text{ mA}$ | – | 60 | ns |
| t_{off} | turn-off time | $-V_{CC} = 6\text{ V}; -I_C = 50\text{ mA};$ $-V_{BE(off)} = 1.9\text{ V}; -I_{B1} = I_{B2} = 5\text{ mA}$ | – | 35 | ns |
| | | $-V_{CC} = 1.5\text{ V}; -I_C = 10\text{ mA};$ $-I_{B1} = I_{B2} = 0.5\text{ mA}$ | – | 75 | ns |

NPN 1 GHz general purpose switching transistor

PMBTH10

FEATURES

- Low cost
- High power gain.

DESCRIPTION

The PMBTH10 is a general purpose silicon npn transistor, encapsulated in a SOT23 plastic envelope. Its pnp complement is the PMBTH81.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: V30 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |

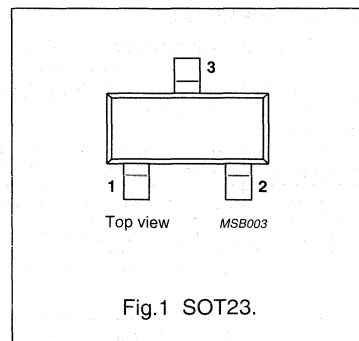


Fig.1 SOT23.

QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|--|---|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 30 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| P_{tot} | total power dissipation | $T_s = 45\text{ °C}$ (note 1) | – | 400 | mW |
| h_{FE} | DC current gain | $V_{CE} = 10\text{ V}; I_C = 4\text{ mA}$ | 60 | – | |
| C_{re} | collector-emitter feedback capacitance | $V_{CB} = 10\text{ V}; I_E = 0; f = 1\text{ MHz}$ | – | 0.7 | pF |
| C_{rb} | collector-base feedback capacitance | $V_{CB} = 10\text{ V}; I_E = 0; f = 1\text{ MHz}$ | 0.35 | 0.65 | pF |
| f_T | transition frequency | $V_{CE} = 10\text{ V}; I_C = 4\text{ mA}; f = 100\text{ MHz}; T_{amb} = 25\text{ °C}$ | 650 | – | MHz |
| $r_b C_C$ | collector-base time constant | $V_{CE} = 10\text{ V}; I_C = 4\text{ mA}; f = 100\text{ MHz}; T_{amb} = 25\text{ °C}$ | – | 9 | ps |

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 30 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 25 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| I_C | DC collector current | | – | 40 | mA |
| P_{tot} | total power dissipation | $T_s = 45\text{ °C}$ (note 1) | – | 400 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 150 | °C |

Note

1. T_s is the temperature at the soldering point of the collector tab.

NPN 1 GHz general purpose switching transistor

PMBTH10

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 260 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

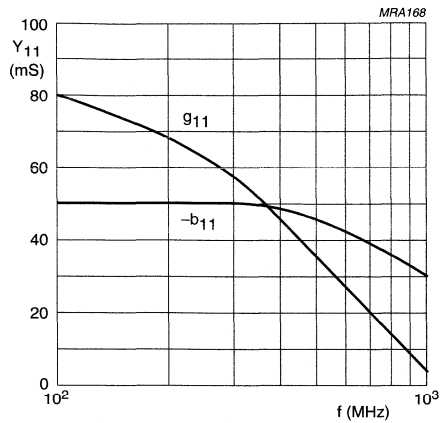
CHARACTERISTICS

 $T_j = 25\text{ }^\circ\text{C}$.

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|--|--|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 100\ \mu\text{A}$; $I_E = 0$ | 30 | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 1\ \text{mA}$; $I_B = 0$ | 25 | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 10\ \mu\text{A}$; $I_C = 0$ | 3 | – | V |
| $V_{CE\ sat}$ | collector-emitter saturation voltage | $I_C = 4\ \text{mA}$; $I_B = 0.4\ \text{mA}$ | – | 0.5 | V |
| $V_{BE\ on}$ | base-emitter ON voltage | $V_{CE} = 10\ \text{V}$; $I_C = 4\ \text{mA}$ | – | 0.95 | V |
| I_{CBO} | collector-base cut-off current | $V_{CB} = 25\ \text{V}$; $I_E = 0$ | – | 100 | nA |
| I_{EBO} | emitter-base cut-off current | $V_{CB} = 25\ \text{V}$; $I_C = 0$ | – | 100 | nA |
| h_{FE} | DC current gain | $V_{CE} = 10\ \text{V}$; $I_C = 4\ \text{mA}$ | 60 | – | |
| C_{re} | collector-emitter feedback capacitance | $V_{CB} = 10\ \text{V}$; $I_E = i_e = 0$; $f = 1\ \text{MHz}$ | – | 0.7 | pF |
| C_{rb} | collector-base feedback capacitance | $V_{CB} = 10\ \text{V}$; $I_C = i_c = 0$; $f = 1\ \text{MHz}$ | 0.35 | 0.65 | pF |
| f_T | transition frequency | $V_{CE} = 10\ \text{V}$; $I_C = 4\ \text{mA}$; $f = 100\ \text{MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | 650 | – | MHz |
| τ_{bC_c} | collector-base time constant | $V_{CB} = 10\ \text{V}$; $I_C = 4\ \text{mA}$; $f = 100\ \text{MHz}$; $T_{amb} = 25\text{ }^\circ\text{C}$ | – | 9 | ps |

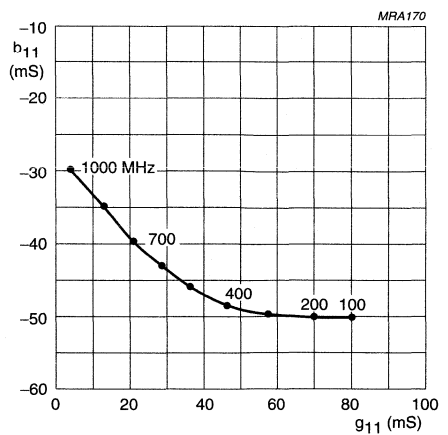
NPN 1 GHz general purpose switching transistor

PMBTH10



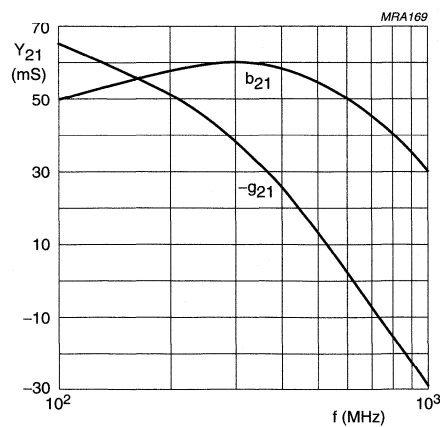
$V_{CB} = 10\text{ V}; I_C = 4\text{ mA}$.

Fig.2 Common base input admittance (Y_{11}) as a function of frequency.



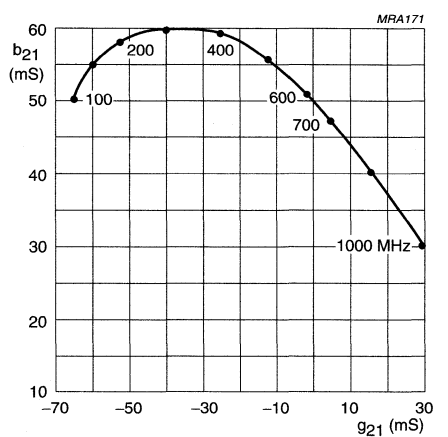
$V_{CB} = 10\text{ V}; I_C = 4\text{ mA}$.

Fig.3 Common base input admittance (Y_{11}).



$V_{CB} = 10\text{ V}; I_C = 4\text{ mA}$.

Fig.4 Common base forward transfer admittance (Y_{21}) as a function of frequency.

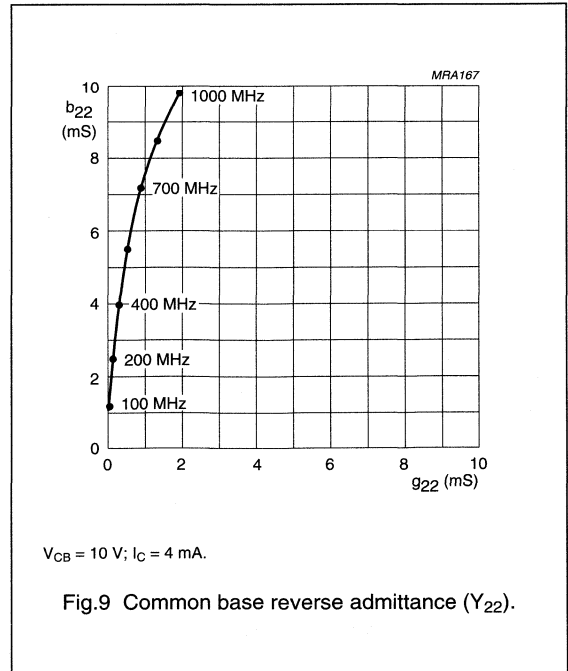
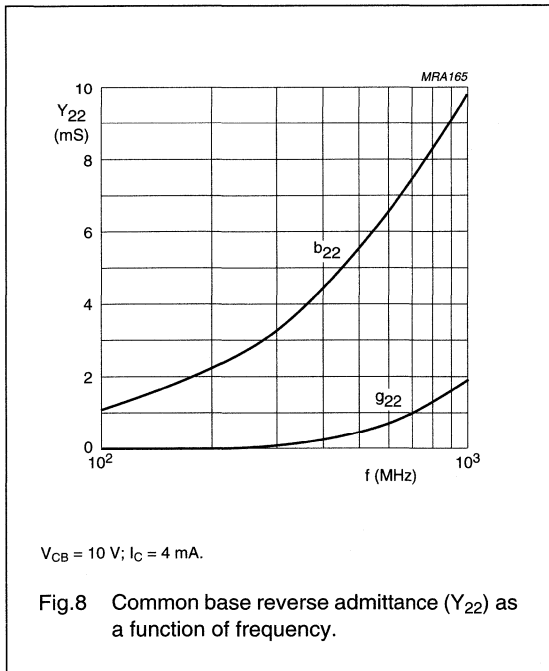
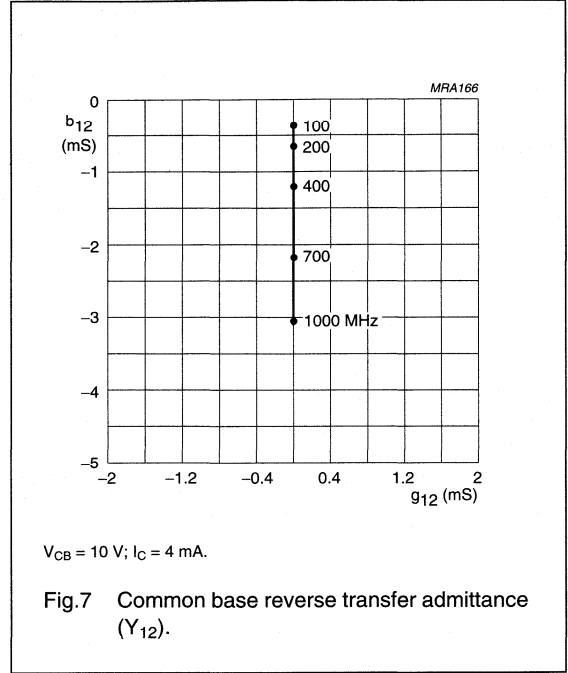
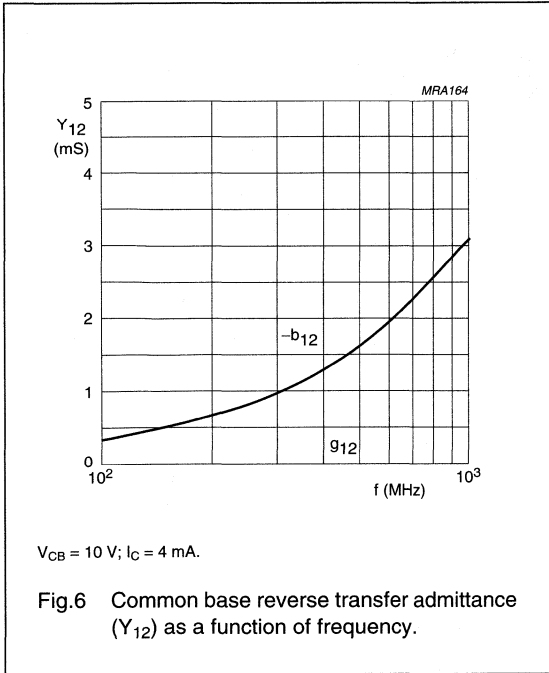


$V_{CB} = 10\text{ V}; I_C = 4\text{ mA}$.

Fig.5 Common base forward transfer admittance (Y_{21}).

NPN 1 GHz general purpose switching transistor

PMBTH10



PNP 1 GHz switching transistor

PMBTH81

FEATURES

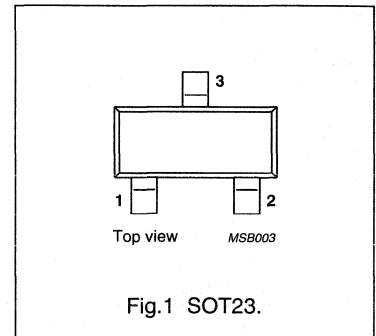
- Low cost
- High transition frequency.

DESCRIPTION

The PMBTH81 is a general purpose silicon pnp transistor, encapsulated in a SOT23 plastic envelope. Its complement is the PMBTH10.

PINNING

| PIN | DESCRIPTION |
|-----------|-------------|
| Code: V31 | |
| 1 | base |
| 2 | emitter |
| 3 | collector |



QUICK REFERENCE DATA

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|-------------------------------|---|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 20 | V |
| P_{tot} | total power dissipation | $T_s = 45\text{ °C}$ (note 1) | – | 400 | mW |
| C_{ce} | collector-emitter capacitance | $V_{CB} = 10\text{ V}; I_B = 0; f = 1\text{ MHz}$ | – | 0.65 | pF |
| C_{cb} | collector-base capacitance | $V_{CB} = 10\text{ V}; I_E = 0; f = 1\text{ MHz}$ | – | 0.85 | pF |
| f_T | transition frequency | $V_{CE} = 10\text{ V}; I_C = 5\text{ mA}; f = 100\text{ MHz}; T_{amb} = 25\text{ °C}$ | 600 | – | MHz |

Note

1. T_s is the temperature at the soldering point of the collector tab.

PNP 1 GHz switching transistor

PMBTH81

LIMITING VALUES

In accordance with the Absolute Maximum System (IEC 134).

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|-----------|---------------------------|-------------------------------|------|------|------|
| V_{CBO} | collector-base voltage | open emitter | – | 20 | V |
| V_{CEO} | collector-emitter voltage | open base | – | 20 | V |
| V_{EBO} | emitter-base voltage | open collector | – | 3 | V |
| I_C | collector current | | – | 40 | mA |
| P_{tot} | total power dissipation | $T_s = 45\text{ °C}$ (note 1) | – | 400 | mW |
| T_{stg} | storage temperature | | –65 | 150 | °C |
| T_j | junction temperature | | – | 150 | °C |

THERMAL RESISTANCE

| SYMBOL | PARAMETER | THERMAL RESISTANCE |
|---------------|---|--------------------|
| $R_{th\ j-s}$ | from junction to soldering point (note 1) | 260 K/W |

Note

- T_s is the temperature at the soldering point of the collector tab.

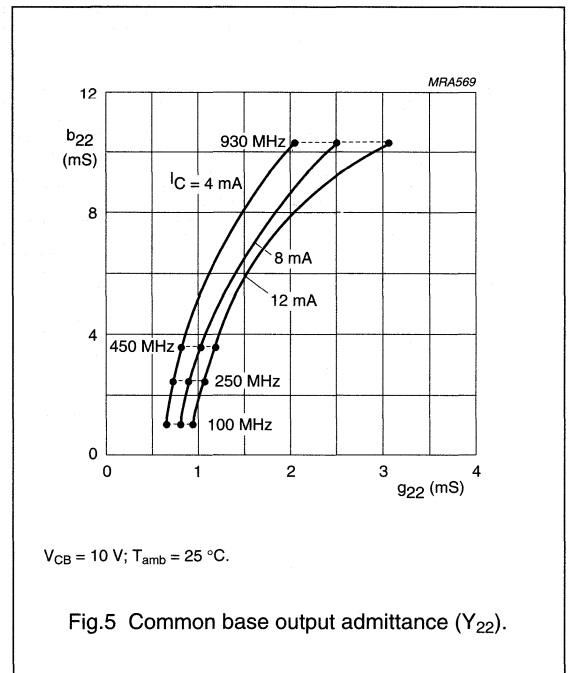
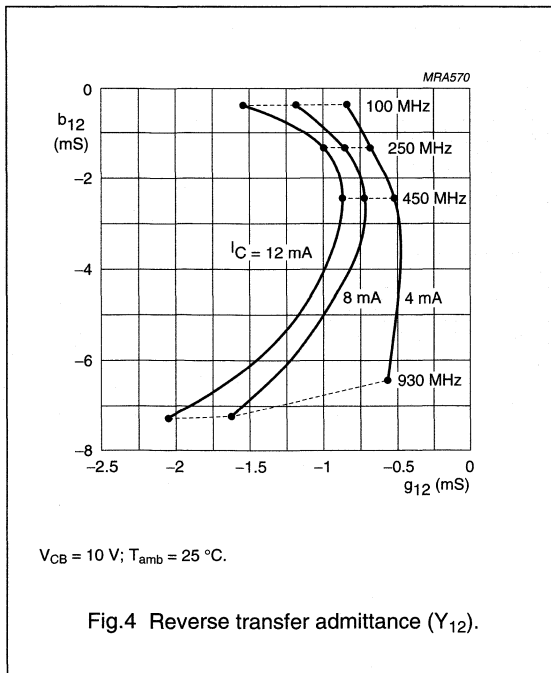
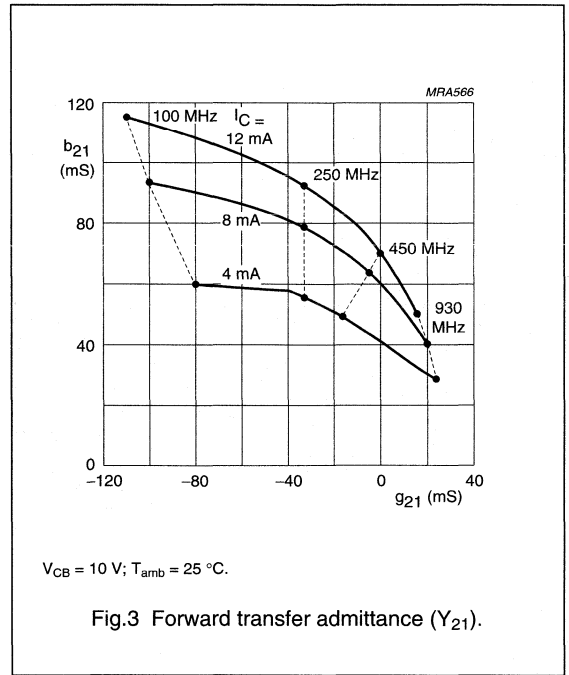
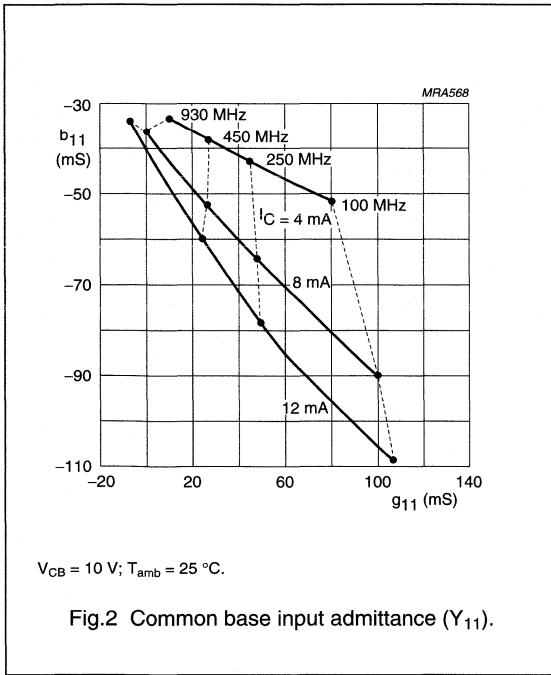
CHARACTERISTICS

$T_j = 25\text{ °C}$

| SYMBOL | PARAMETER | CONDITIONS | MIN. | MAX. | UNIT |
|---------------|--------------------------------------|--|------|------|------|
| $V_{(BR)CBO}$ | collector-base breakdown voltage | open emitter; $I_C = 10\ \mu\text{A}$; $I_E = 0$ | 20 | – | V |
| $V_{(BR)CEO}$ | collector-emitter breakdown voltage | open base; $I_C = 1\ \text{mA}$; $I_B = 0$ | 20 | – | V |
| $V_{(BR)EBO}$ | emitter-base breakdown voltage | open collector; $I_E = 10\ \mu\text{A}$; $I_C = 0$ | 3 | – | V |
| $V_{CE\ sat}$ | collector-emitter saturation voltage | $I_C = 5\ \text{mA}$; $I_B = 0.5\ \text{mA}$ | – | 0.5 | V |
| $V_{BE\ on}$ | base-emitter ON voltage | $V_{CE} = 10\ \text{V}$; $I_C = 5\ \text{mA}$ | – | 0.9 | V |
| I_{CBO} | collector-base cut-off current | $V_{CB} = 10\ \text{V}$; $I_E = 0$ | – | 100 | nA |
| I_{EBO} | emitter-base cut-off current | $V_{EB} = 2\ \text{V}$; $I_C = 0$ | – | 100 | nA |
| h_{FE} | DC current gain | $V_{CE} = 10\ \text{V}$; $I_C = 5\ \text{mA}$ | 60 | – | |
| C_{ce} | collector-emitter capacitance | $V_{CB} = 10\ \text{V}$; $I_B = 0$; $f = 1\ \text{MHz}$ | – | 0.65 | pF |
| C_{cb} | collector-base capacitance | $V_{CB} = 10\ \text{V}$; $I_E = 0$; $f = 1\ \text{MHz}$ | – | 0.85 | pF |
| f_T | transition frequency | $V_{CE} = 10\ \text{V}$; $I_C = 5\ \text{mA}$; $f = 100\ \text{MHz}$; $T_{amb} = 25\text{ °C}$ | 600 | – | MHz |

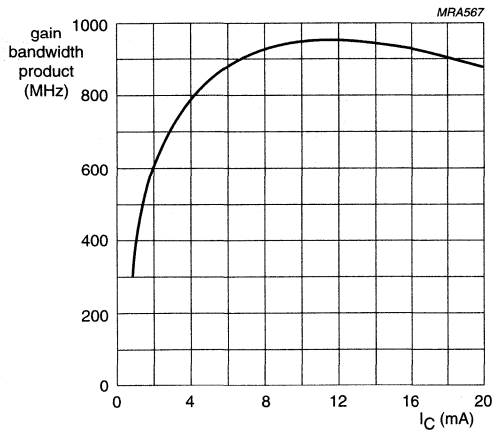
PNP 1 GHz switching transistor

PMBTH81



PNP 1 GHz switching transistor

PMBTH81



$V_{CE} = 10$ V; $f = 100$ MHz.

Fig.6 Current gain-bandwidth product as a function of collector current.

PACKAGE OUTLINES

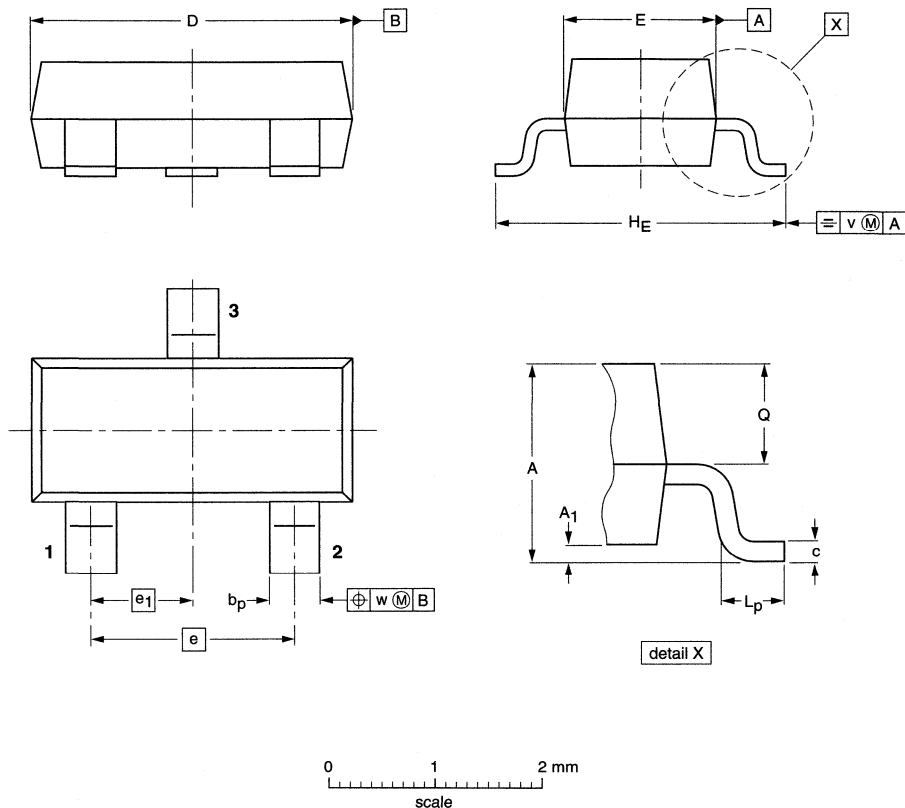
| Package | Surface-mount | Page |
|--------------|---------------|----------|
| SOT23 | yes | 744. |
| SOT54 | no |745 |
| SOT54variant | no | 746 |
| SOT89 | yes |747 |
| SOT122A | no |748 |
| SOT122E | no |749 |
| SOT143B | yes |750 |
| SOT143R | yes |751 |
| SOT172A1 | no |752 |
| SOT172A2 | no |753 |
| SOT223 | yes |754 |
| SOT323 | yes |755 |
| SOT343N | yes |756 |
| SOT343R | yes |757 |
| SOT353 | yes |758 |
| SOT363 | yes |759 |

RF Wideband Transistors

Package outlines

Plastic surface mounted package; 3 leads

SOT23



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max. | b _p | c | D | E | e | e ₁ | H _E | L _p | Q | v | w |
|------|------------|------------------------|----------------|--------------|------------|------------|-----|----------------|----------------|----------------|--------------|-----|-----|
| mm | 1.1 0.9 | 0.1 | 0.48 0.38 | 0.15 0.09 | 3.0 2.8 | 1.4 1.2 | 1.9 | 0.95 | 2.5 2.1 | 0.45 0.15 | 0.55 0.45 | 0.2 | 0.1 |

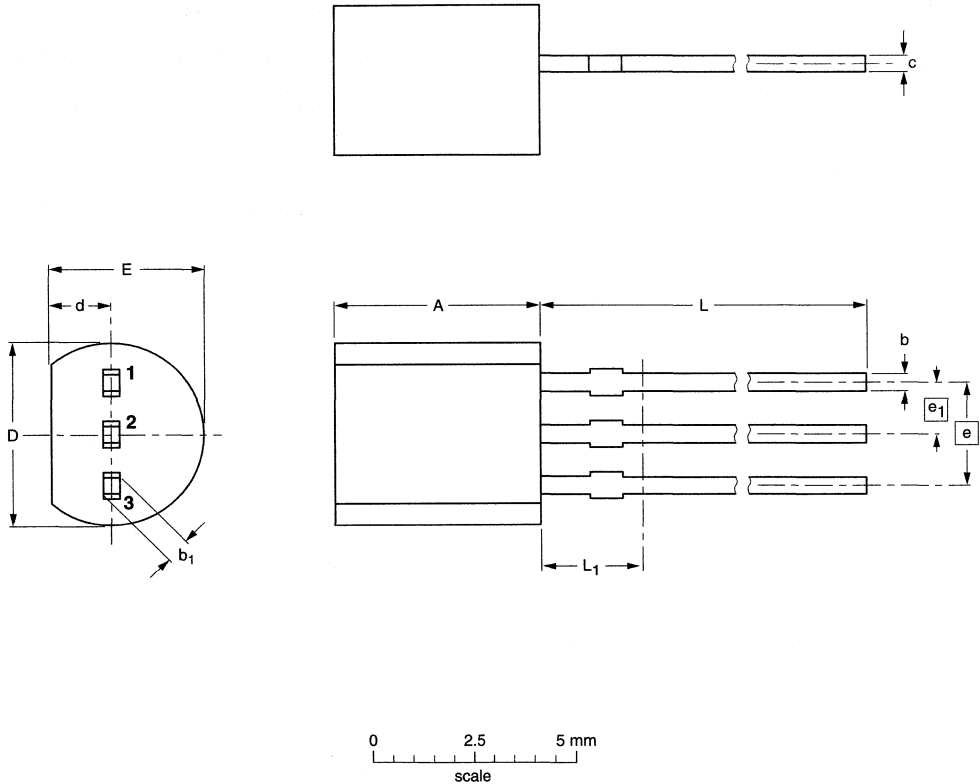
| OUTLINE VERSION | REFERENCES | | | EUROPEAN PROJECTION | ISSUE DATE |
|--------------------|------------|-------|------|------------------------|------------|
| | IEC | JEDEC | EIAJ | | |
| SOT23 | | | | | 97-02-28 |

RF Wideband Transistors

Package outlines

Plastic single-ended leaded (through hole) package; 3 leads

SOT54



DIMENSIONS (mm are the original dimensions)

| UNIT | A | b | b ₁ | c | D | d | E | e | e ₁ | L | L ₁ ⁽¹⁾ |
|------|------------|--------------|----------------|--------------|------------|------------|------------|------|----------------|--------------|-------------------------------|
| mm | 5.2 5.0 | 0.48 0.40 | 0.66 0.56 | 0.45 0.40 | 4.8 4.4 | 1.7 1.4 | 4.2 3.6 | 2.54 | 1.27 | 14.5 12.7 | 2.5 |

Note

1. Terminal dimensions within this zone are uncontrolled to allow for flow of plastic and terminal irregularities.

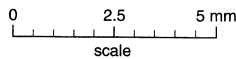
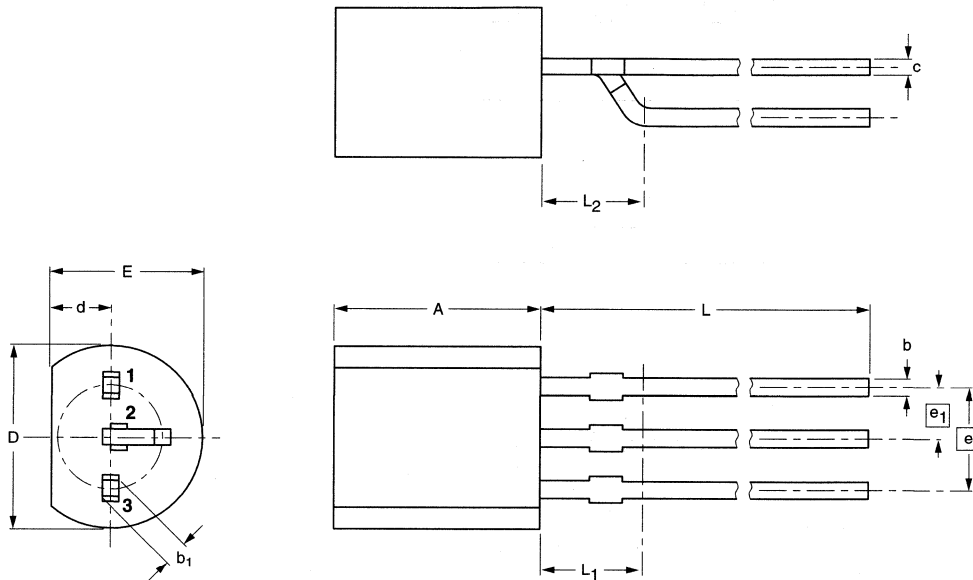
| OUTLINE VERSION | REFERENCES | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|-------|---------------------|------------|
| | IEC | JEDEC | EIAJ | | |
| SOT54 | | TO-92 | SC-43 | | 97-02-28 |

RF Wideband Transistors

Package outlines

Plastic single-ended leaded (through hole) package; 3 leads (on-circle)

SOT54 variant



DIMENSIONS (mm are the original dimensions)

| UNIT | A | b | b ₁ | c | D | d | E | e | e ₁ | L | L ₁ ⁽¹⁾ max | L ₂ max |
|------|------------|--------------|----------------|--------------|------------|------------|------------|------|----------------|--------------|--------------------------------------|-----------------------|
| mm | 5.2 5.0 | 0.48 0.40 | 0.66 0.56 | 0.45 0.40 | 4.8 4.4 | 1.7 1.4 | 4.2 3.6 | 2.54 | 1.27 | 14.5 12.7 | 2.5 | 2.5 |

Notes

1. Terminal dimensions within this zone are uncontrolled to allow for flow of plastic and terminal irregularities.

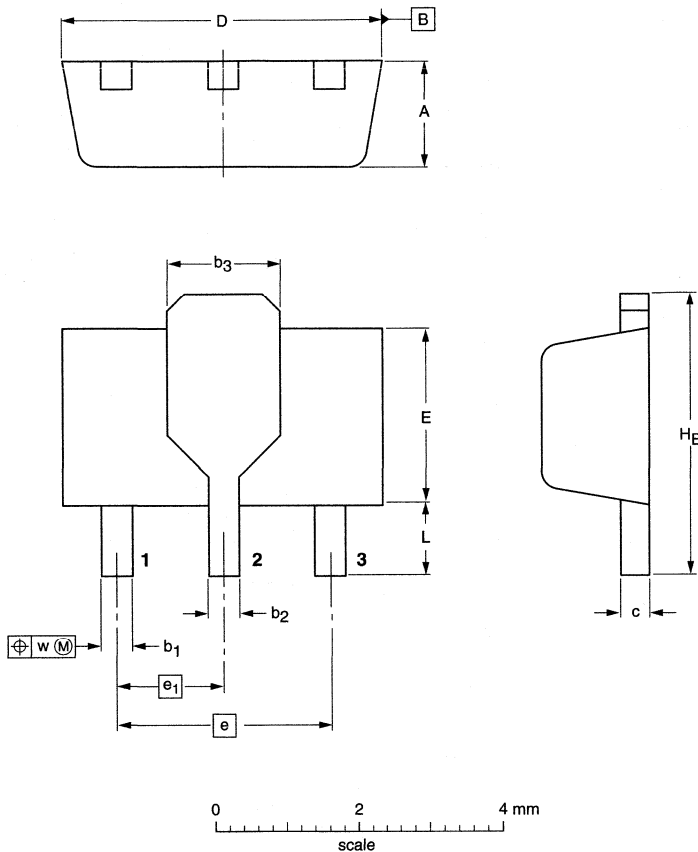
| OUTLINE VERSION | REFERENCES | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|-------|---------------------|------------|
| | IEC | JEDEC | EIAJ | | |
| SOT54 variant | | TO-92 | SC-43 | | 97-04-14 |

RF Wideband Transistors

Package outlines

Plastic surface mounted package; collector pad for good heat transfer; 3 leads

SOT89



DIMENSIONS (mm are the original dimensions)

| UNIT | A | b ₁ | b ₂ | b ₃ | c | D | E | e | e ₁ | H _E | L min. | w |
|------|------------|----------------|----------------|----------------|--------------|------------|------------|-----|----------------|----------------|--------|------|
| mm | 1.6 1.4 | 0.48 0.35 | 0.53 0.40 | 1.8 1.4 | 0.44 0.37 | 4.6 4.4 | 2.6 2.4 | 3.0 | 1.5 | 4.25 3.75 | 0.8 | 0.13 |

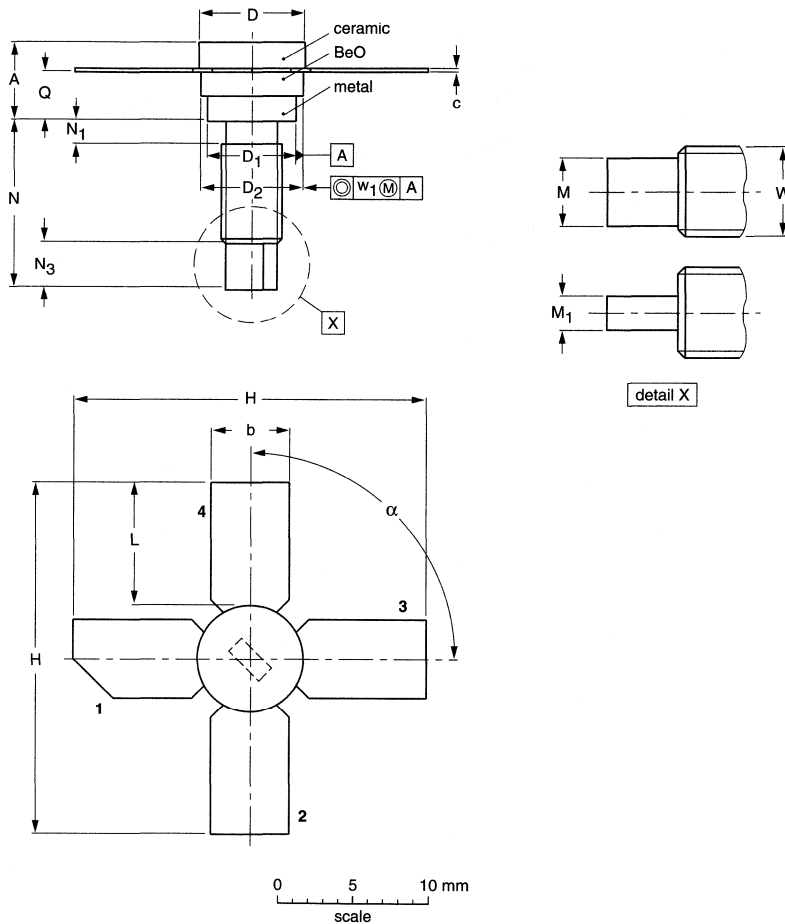
| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|------|--|---------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT89 | | | | | | 97-02-28 |

RF Wideband Transistors

Package outlines

Studded ceramic package; 4 leads

SOT122A



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

| UNIT | A | b | c | D | D ₁ | D ₂ | H | L | M ₁ | M | N | N ₁ max. | N ₃ | Q | W | w ₁ | α |
|------|--------------|--------------|--------------|--------------|----------------|----------------|----------------|--------------|----------------|--------------|----------------|---------------------|----------------|--------------|-------------|----------------|-----|
| mm | 5.97 4.74 | 5.85 5.58 | 0.18 0.14 | 7.50 7.23 | 6.48 6.22 | 7.24 6.93 | 27.56 25.78 | 9.91 9.14 | 3.18 2.66 | 1.66 1.39 | 11.82 11.04 | 1.02 | 3.86 2.92 | 3.38 2.74 | 8-32 UNC | 0.381 | 90° |

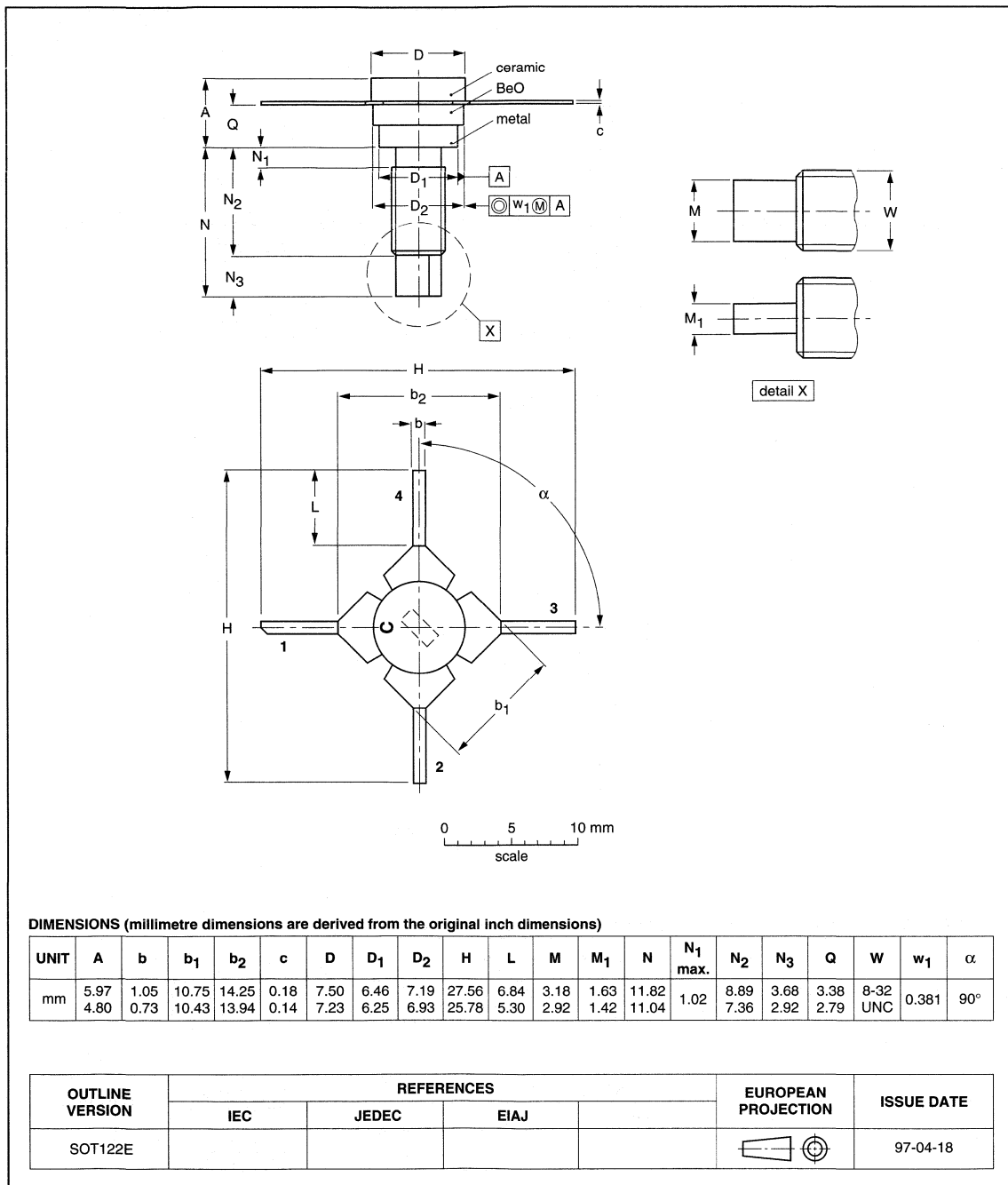
| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|------|--|---------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT122A | | | | | | 97-04-18 |

RF Wideband Transistors

Package outlines

Studded ceramic package; 4 leads

SOT122E

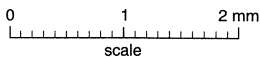
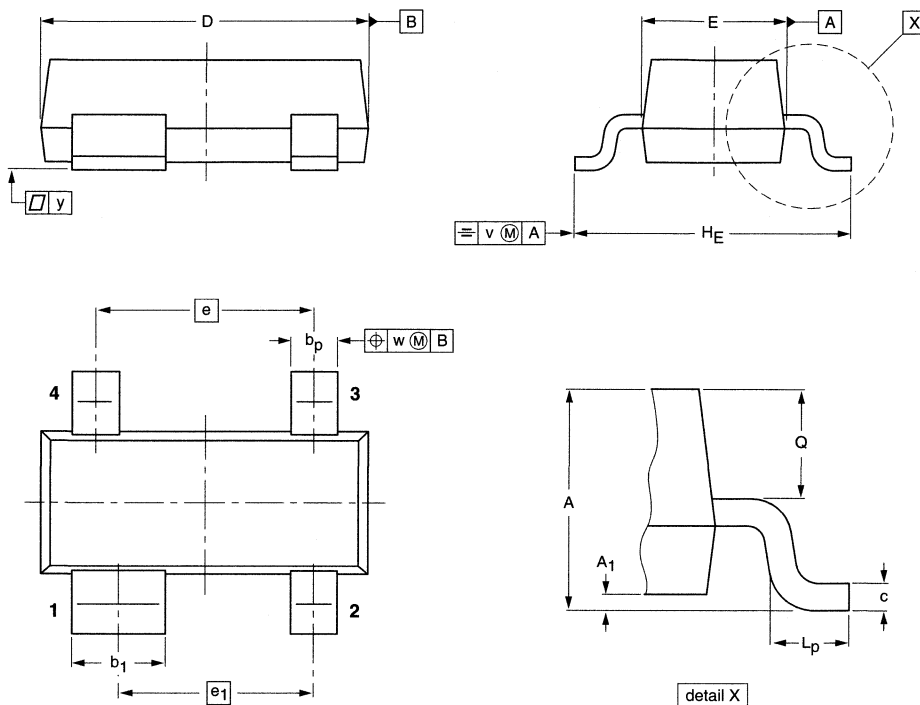


RF Wideband Transistors

Package outlines

Plastic surface mounted package; 4 leads

SOT143B



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max | b _p | b ₁ | c | D | E | e | e ₁ | H _E | L _p | Q | v | w | y |
|------|------------|-----------------------|----------------|----------------|--------------|------------|------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm | 1.1 0.9 | 0.1 | 0.48 0.38 | 0.88 0.78 | 0.15 0.09 | 3.0 2.8 | 1.4 1.2 | 1.9 | 1.7 | 2.5 2.1 | 0.45 0.15 | 0.55 0.45 | 0.2 | 0.1 | 0.1 |

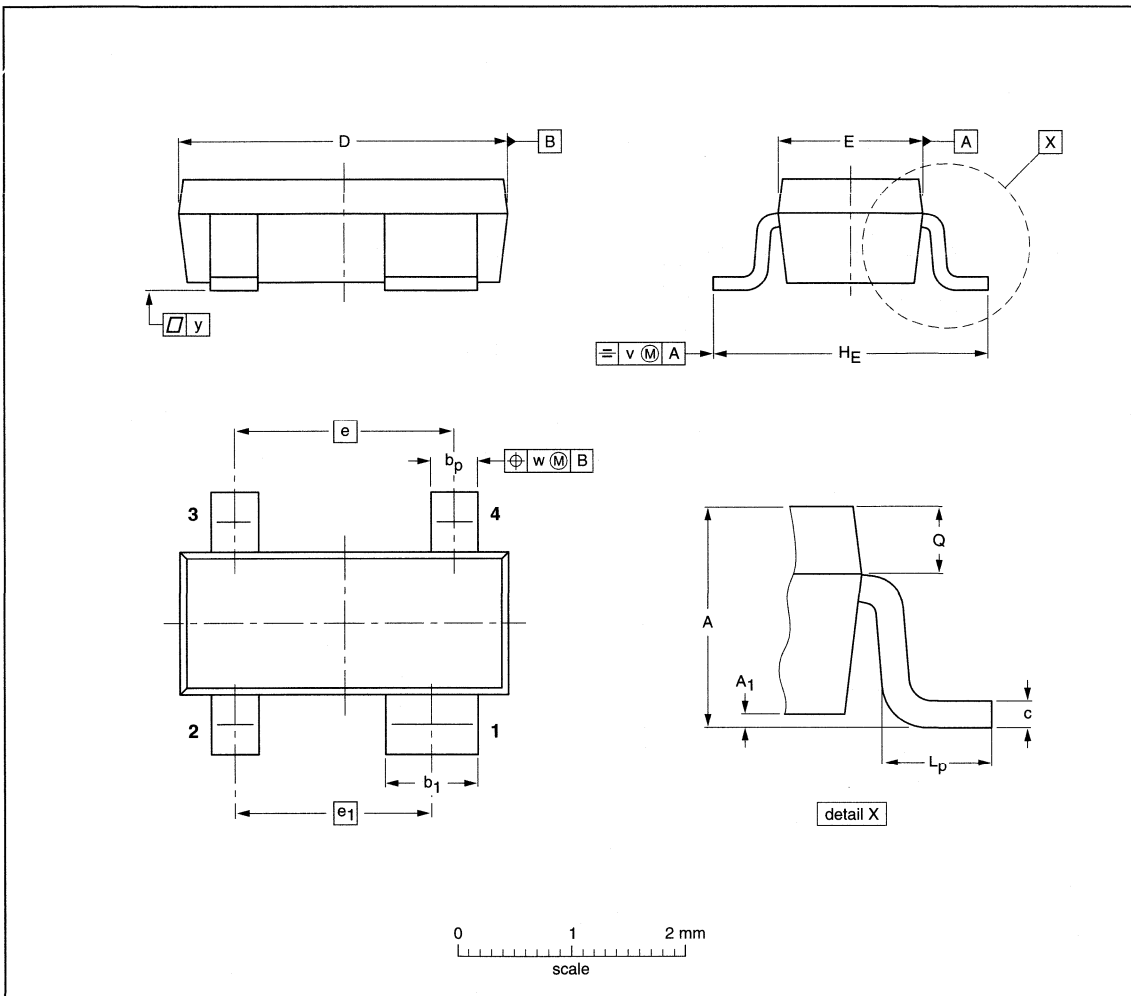
| OUTLINE VERSION | REFERENCES | | | EUROPEAN PROJECTION | ISSUE DATE |
|--------------------|------------|-------|------|------------------------|------------|
| | IEC | JEDEC | EIAJ | | |
| SOT143B | | | | | 97-02-28 |

RF Wideband Transistors

Package outlines

Plastic surface mounted package; reverse pinning; 4 leads

SOT143R



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max | b _p | b ₁ | c | D | E | e | e ₁ | H _E | L _p | Q | v | w | y |
|------|------------|--------------------|----------------|----------------|--------------|------------|------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm | 1.1 0.9 | 0.1 | 0.48 0.38 | 0.88 0.78 | 0.15 0.09 | 3.0 2.8 | 1.4 1.2 | 1.9 | 1.7 | 2.5 2.1 | 0.55 0.25 | 0.45 0.25 | 0.2 | 0.1 | 0.1 |

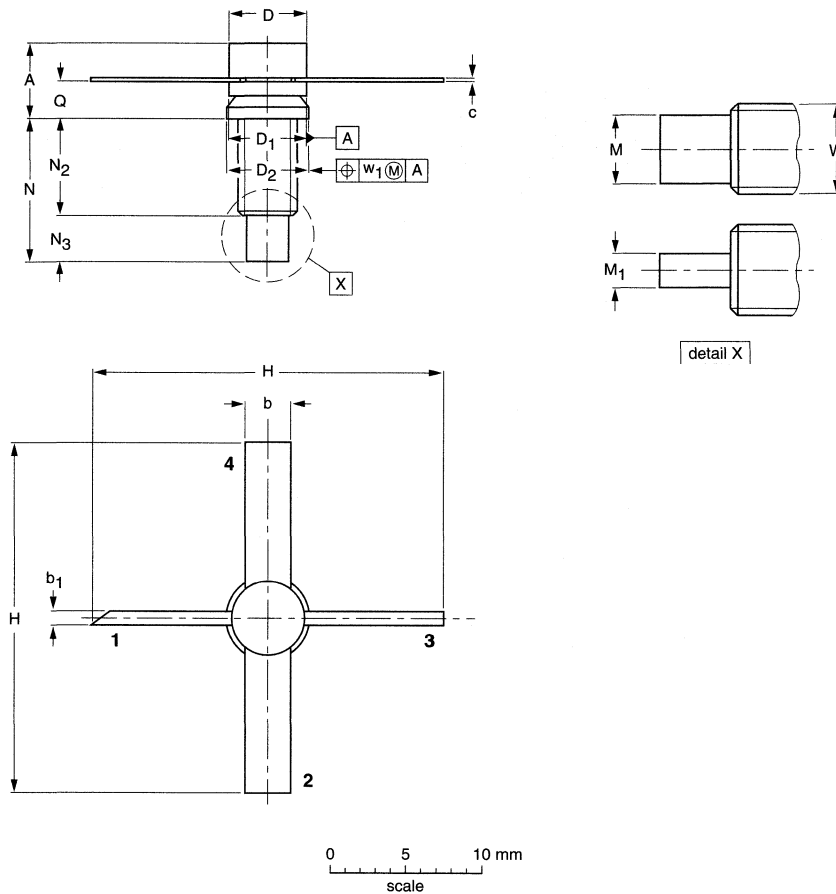
| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|------|--|---------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT143R | | | | | | 97-03-10 |

RF Wideband Transistors

Package outlines

Studded ceramic package; 4 leads

SOT172A1



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

| UNIT | A | b | b ₁ | c | D | D ₁ | D ₂ | H | M | M ₁ | N | N ₂ | N ₃ | Q | W | w ₁ |
|--------|----------------|----------------|----------------|----------------|----------------|----------------|----------------|----------------|--------------|----------------|----------------|----------------|----------------|----------------|-------------|----------------|
| mm | 5.31 4.34 | 3.31 3.04 | 0.89 0.63 | 0.16 0.10 | 5.20 4.95 | 5.33 5.08 | 5.33 5.08 | 26.17 24.63 | 3.05 2.79 | 1.66 1.39 | 11.82 10.89 | 8.89 6.90 | 3.69 2.92 | 2.90 2.31 | 8-32 UNC | 0.38 |
| inches | 0.209 0.171 | 0.130 0.120 | 0.035 0.025 | 0.006 0.004 | 0.205 0.195 | 0.210 0.200 | 0.210 0.200 | 1.03 0.97 | 0.12 0.11 | 0.065 0.055 | 0.465 0.429 | 0.350 0.272 | 0.145 0.115 | 0.114 0.091 | | 0.015 |

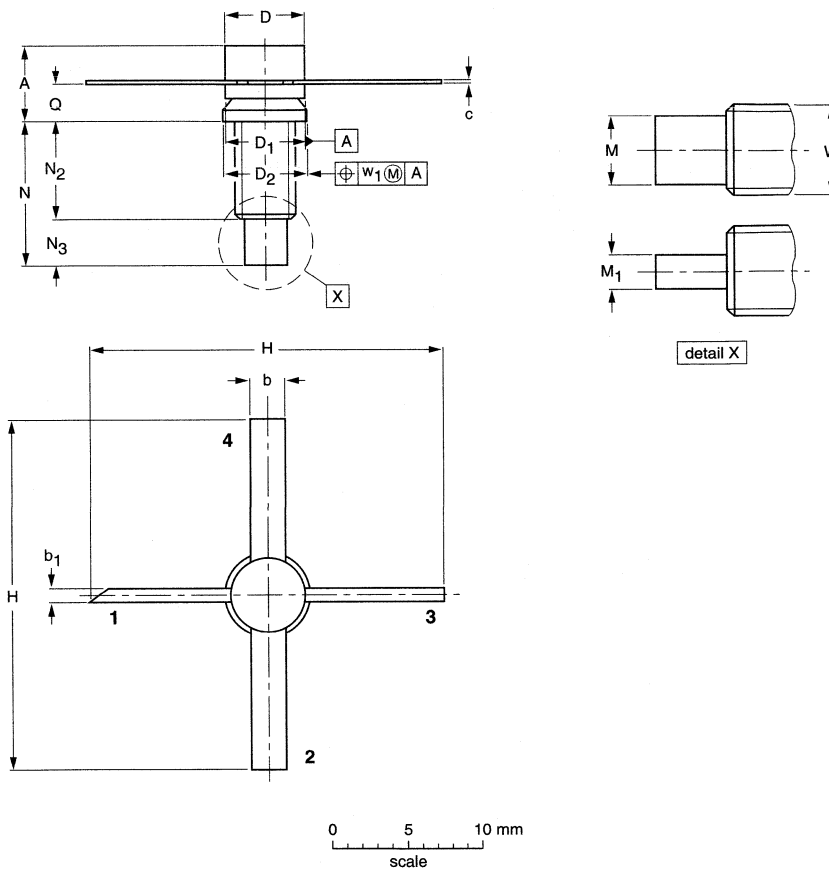
| OUTLINE VERSION | REFERENCES | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|------|---------------------|------------|
| | IEC | JEDEC | EIAJ | | |
| SOT172A1 | | | | | 97-06-28 |

RF Wideband Transistors

Package outlines

Studded ceramic package; 4 leads

SOT172A2



DIMENSIONS (millimetre dimensions are derived from the original inch dimensions)

| UNIT | A | b | b ₁ | c | D | D ₁ | D ₂ | H | M | M ₁ | N | N ₂ | N ₃ | Q | W | w ₁ |
|--------|----------------|----------------|----------------|----------------|----------------|----------------|----------------|----------------|--------------|----------------|----------------|----------------|----------------|----------------|-------------|----------------|
| mm | 5.51 4.45 | 1.66 1.39 | 0.89 0.63 | 0.16 0.10 | 5.20 4.95 | 5.33 5.08 | 5.33 5.08 | 23.37 22.35 | 3.05 2.79 | 1.66 1.39 | 11.56 11.04 | 8.38 7.62 | 3.69 2.92 | 2.95 2.43 | 8-32 UNC | 0.38 |
| inches | 0.217 0.175 | 0.065 0.055 | 0.035 0.025 | 0.006 0.004 | 0.205 0.195 | 0.210 0.200 | 0.210 0.200 | 0.92 0.88 | 0.12 0.11 | 0.065 0.055 | 0.465 0.435 | 0.33 0.30 | 0.145 0.115 | 0.116 0.096 | | 0.015 |

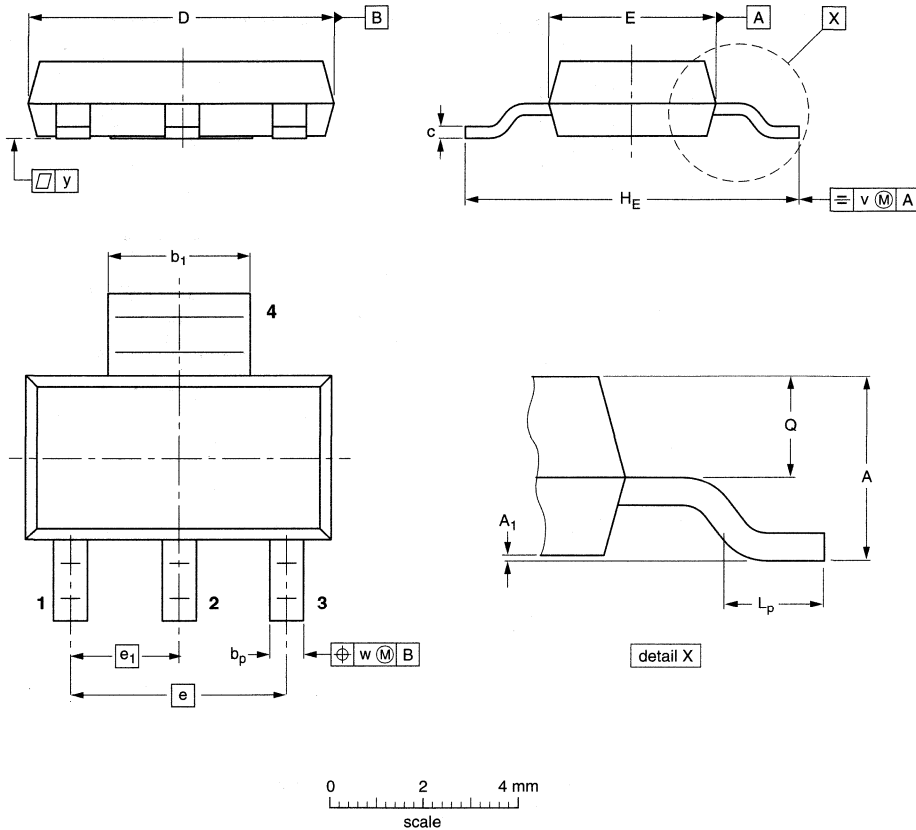
| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|------|--|---------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT172A2 | | | | | | 97-06-28 |

RF Wideband Transistors

Package outlines

Plastic surface mounted package; collector pad for good heat transfer; 4 leads

SOT223



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ | b _p | b ₁ | c | D | E | e | e ₁ | H _E | L _p | Q | v | w | y |
|------|------------|----------------|----------------|----------------|--------------|------------|------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm | 1.8 1.5 | 0.10 0.01 | 0.80 0.60 | 3.1 2.9 | 0.32 0.22 | 6.7 6.3 | 3.7 3.3 | 4.6 | 2.3 | 7.3 6.7 | 1.1 0.7 | 0.95 0.85 | 0.2 | 0.1 | 0.1 |

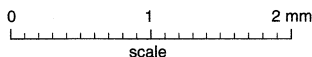
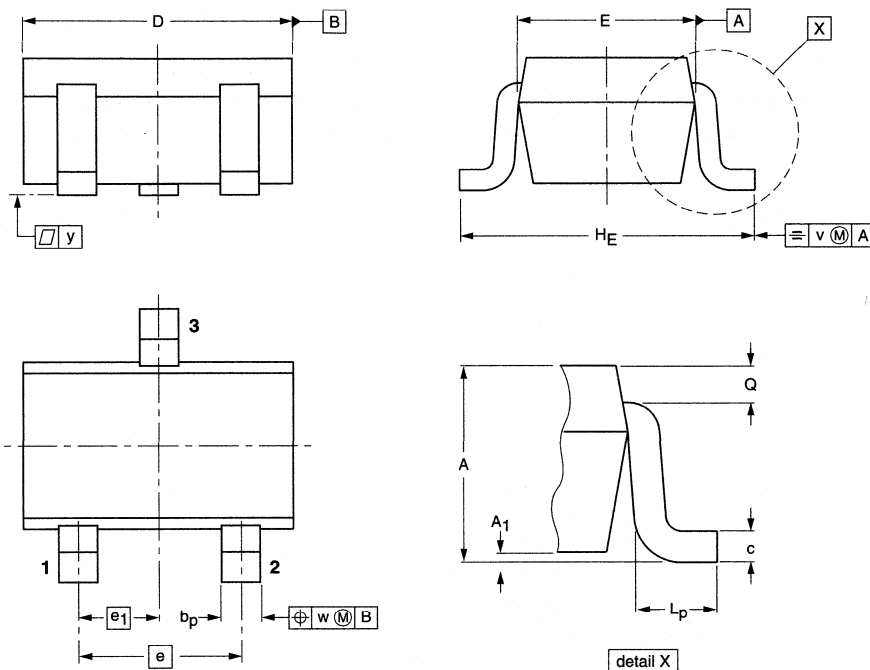
| OUTLINE VERSION | REFERENCES | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|------|---------------------|----------------------|
| | IEC | JEDEC | EIAJ | | |
| SOT223 | | | | | 96-11-11 97-02-28 |

RF Wideband Transistors

Package outlines

Plastic surface mounted package; 3 leads

SOT323



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max | b _p | c | D | E | e | e ₁ | H _E | L _p | Q | v | w |
|------|------------|-----------------------|----------------|--------------|------------|--------------|-----|----------------|----------------|----------------|--------------|-----|-----|
| mm | 1.1 0.8 | 0.1 | 0.4 0.3 | 0.25 0.10 | 2.2 1.8 | 1.35 1.15 | 1.3 | 0.65 | 2.2 2.0 | 0.45 0.15 | 0.23 0.13 | 0.2 | 0.2 |

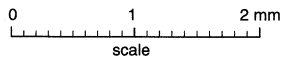
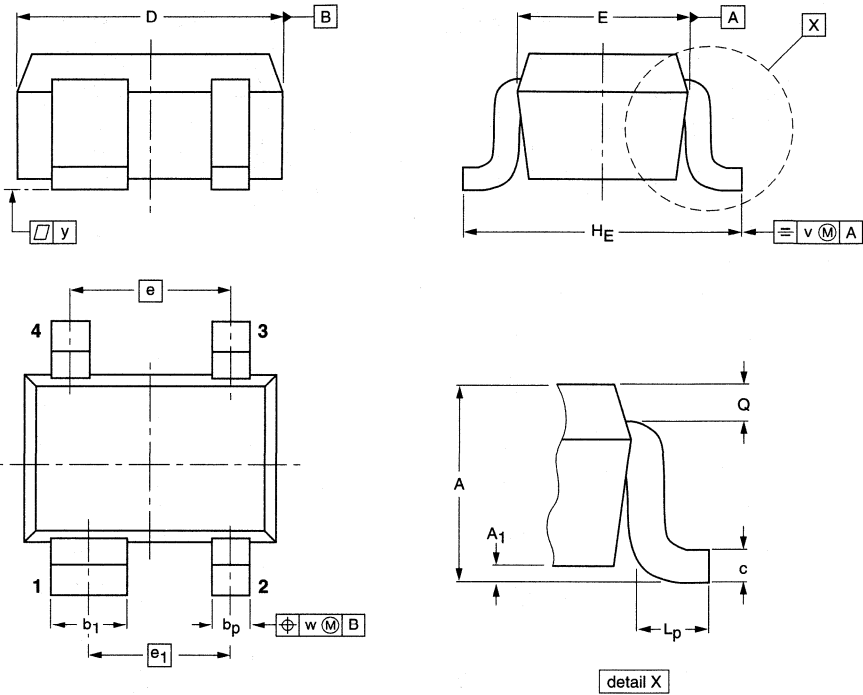
| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|--------------------|------------|-------|-------|--|------------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT323 | | | SC-70 | | | 97-02-28 |

RF Wideband Transistors

Package outlines

Plastic surface mounted package; 4 leads

SOT343N



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max | b _p | b ₁ | c | D | E | e | e ₁ | H _E | L _p | Q | v | w | y |
|------|------------|--------------------|----------------|----------------|--------------|------------|--------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm | 1.1 0.8 | 0.1 | 0.4 0.3 | 0.7 0.5 | 0.25 0.10 | 2.2 1.8 | 1.35 1.15 | 1.3 | 1.15 | 2.2 2.0 | 0.45 0.15 | 0.23 0.13 | 0.2 | 0.2 | 0.1 |

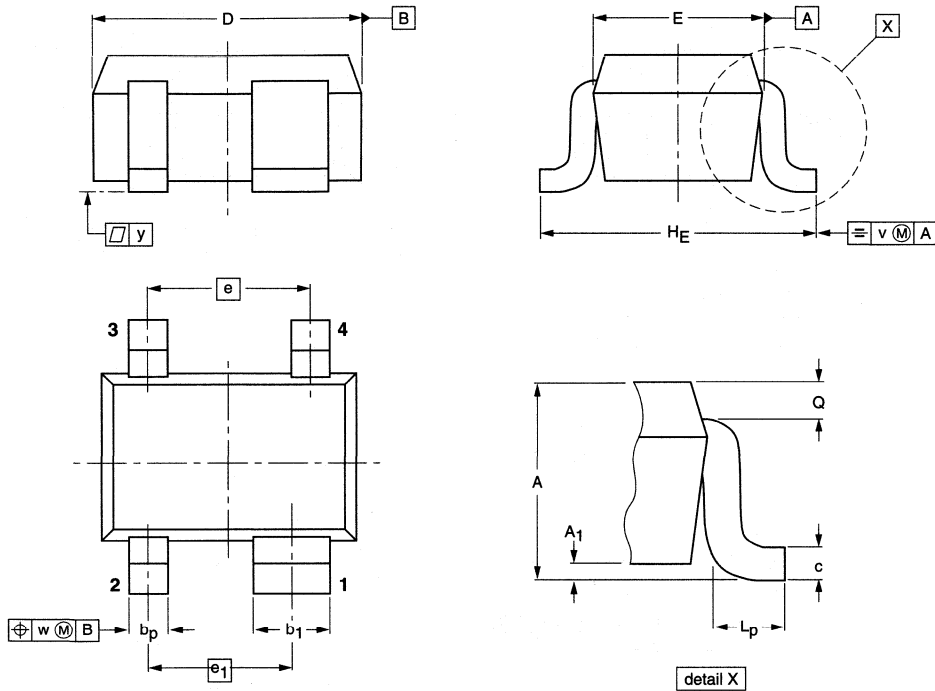
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|-----------------|------------|-------|------|--|---------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT343N | | | | | | 97-05-21 |

RF Wideband Transistors

Package outlines

Plastic surface mounted package; reverse pinning; 4 leads

SOT343R



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max | b _p | b ₁ | c | D | E | e | e ₁ | H _E | L _p | Q | v | w | y |
|------|------------|--------------------|----------------|----------------|--------------|------------|--------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm | 1.1 0.8 | 0.1 | 0.4 0.3 | 0.7 0.5 | 0.25 0.10 | 2.2 1.8 | 1.35 1.15 | 1.3 | 1.15 | 2.2 2.0 | 0.45 0.15 | 0.23 0.13 | 0.2 | 0.2 | 0.1 |

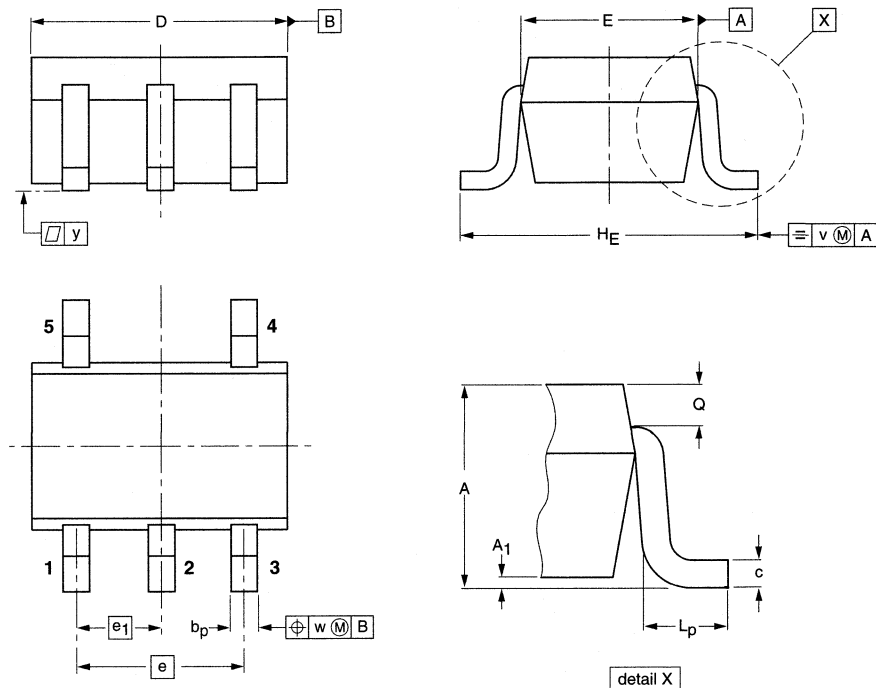
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|-----------------|------------|-------|------|--|---------------------|------------|
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| SOT343R | | | | | | 97-05-21 |

RF Wideband Transistors

Package outlines

Plastic surface mounted package; 5 leads

SOT353



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max | b _p | c | D | E ⁽²⁾ | e | e ₁ | H _E | L _p | Q | v | w | y |
|------|------------|--------------------|----------------|--------------|------------|------------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm | 1.1 0.8 | 0.1 | 0.30 0.20 | 0.25 0.10 | 2.2 1.8 | 1.35 1.15 | 1.3 | 0.65 | 2.2 2.0 | 0.45 0.15 | 0.25 0.15 | 0.2 | 0.2 | 0.1 |

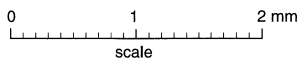
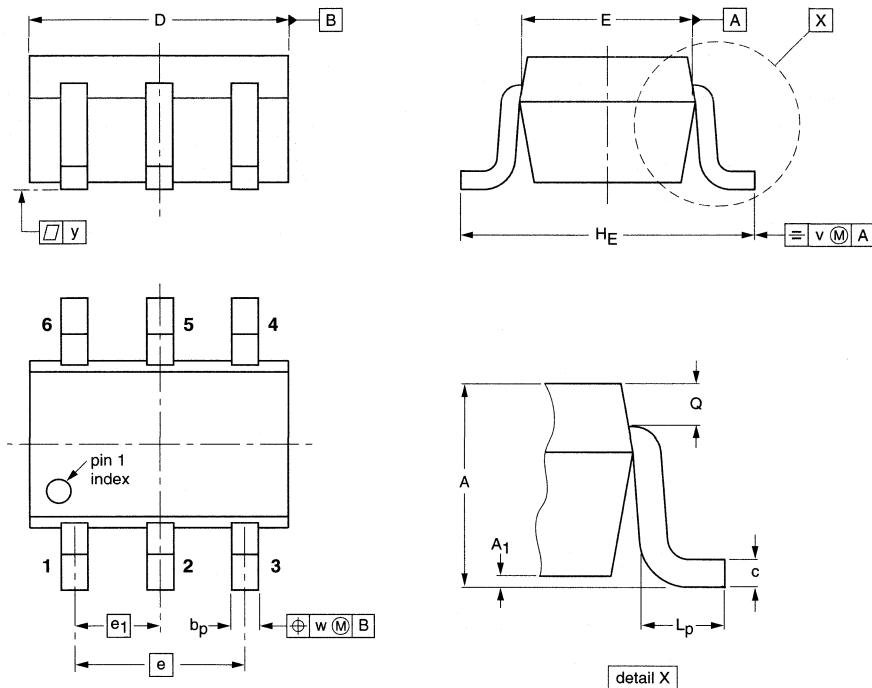
| OUTLINE VERSION | REFERENCES | | | | EUROPEAN PROJECTION | ISSUE DATE |
|-----------------|------------|-------|--------|--|---------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
| SOT353 | | | SC-88A | | | 97-02-28 |

RF Wideband Transistors

Package outlines

Plastic surface mounted package; 6 leads

SOT363



DIMENSIONS (mm are the original dimensions)

| UNIT | A | A ₁ max | b _p | c | D | E | e | e ₁ | H _E | L _p | Q | v | w | y |
|------|------------|-----------------------|----------------|--------------|------------|--------------|-----|----------------|----------------|----------------|--------------|-----|-----|-----|
| mm | 1.1 0.8 | 0.1 | 0.30 0.20 | 0.25 0.10 | 2.2 1.8 | 1.35 1.15 | 1.3 | 0.65 | 2.2 2.0 | 0.45 0.15 | 0.25 0.15 | 0.2 | 0.2 | 0.1 |

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|--------------------|------------|-------|-------|--|------------------------|------------|
| | IEC | JEDEC | EIAJ | | | |
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| DC05 | Wire Wound Components |

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| | |
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| MA04 | Dry-reed Switches |

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